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Radio transmission and reception;  
Part 2: Range 2 standalone  
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# Foreword

This Technical Specification has been produced by the 3rd Generation Partnership Project (3GPP).

The contents of the present document are subject to continuing work within the TSG and may change following formal TSG approval. Should the TSG modify the contents of the present document, it will be re-released by the TSG with an identifying change of release date and an increase in version number as follows:

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The present document is part 2 of a multi-part Technical Specification (TS) covering the New Radio (NR) User Equipment (UE) conformance specification, which is divided in the following parts:

3GPP TS 38.521-1 [13]: NR; User Equipment (UE) conformance specification; Radio transmission and reception; Part 1: Range 1 Standalone;

**3GPP TS 38.521-2: NR; User Equipment (UE) conformance specification; Radio transmission and reception; Part 2: Range 2 Standalone;**

3GPP TS 38.521-3 [14]: NR; User Equipment (UE) conformance specification; Radio transmission and reception; Part 3: Range 1 and Range 2 Interworking operation with other radios;

3GPP TS 38.521-4 [15]: NR; User Equipment conformance specification; Radio transmission and reception; Part 4: Performance;

3GPP TS 38.522 [16]: NR; User Equipment (UE) conformance specification; Applicability of radio transmission, radio reception and radio resource management test cases;

3GPP TS 38.533 [17]: NR; User Equipment (UE) conformance specification; Radio resource management (RRM);

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# 1 Scope

The present document specifies the measurement procedures for the conformance test of the user equipment (UE) that contain RF characteristics for frequency Range 2 as part of the 5G-NR.

The requirements are listed in different clauses only if the corresponding parameters deviate. More generally, tests are only applicable to those mobiles that are intended to support the appropriate functionality. To indicate the circumstances in which tests apply, this is noted in the "*definition and applicability*" part of the test.

For example only Release 15 and later UE declared to support 5G-NR shall be tested for this functionality. In the event that for some tests different conditions apply for different releases, this is indicated within the text of the test itself.

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# 2 References

The following documents contain provisions which, through reference in this text, constitute provisions of the present document.

- References are either specific (identified by date of publication, edition number, version number, etc.) or non-specific.
- For a specific reference, subsequent revisions do not apply.
- For a non-specific reference, the latest version applies. In the case of a reference to a 3GPP document (including a GSM document), a non-specific reference implicitly refers to the latest version of that document *in the same Release as the present document*.

- [1] 3GPP.TR 21.905: "Vocabulary for 3GPP Specifications".
- [2] 3GPP TS 38.101-1: "NR; User Equipment (UE) radio transmission and reception; Part 1: Range 1 Standalone".
- [3] 3GPP TS 38.101-2: "NR; User Equipment (UE) radio transmission and reception; Part 2: Range 2 Standalone".
- [4] 3GPP TS 38.101-3: "NR; User Equipment (UE) radio transmission and reception; Part 3: Range 1 and Range 2 Interworking operation with other radios".
- [5] 3GPP TR 38.810: "Study on test methods for New Radio".
- [6] ITU-R Recommendation M.1545: "Measurement uncertainty as it applies to test limits for the terrestrial component of International Mobile Telecommunications-2000".
- [7] ITU-R Recommendation SM.329-10: "Unwanted emissions in the spurious domain".
- [8] FCC 47 CFR Part 30: "UPPER MICROWAVE FLEXIBLE USE SERVICE, §30.202 Power limits".
- [9] 3GPP TS 38.211: "NR; Physical channels and modulation".
- [10] 3GPP TS 38.508-1: "5GS; User Equipment (UE) conformance specification; Part 1: Common test environment".
- [11] 3GPP TS 38.508-2: "5GS; User Equipment (UE) conformance specification; Part 2: Common Implementation Conformance Statement (ICS) proforma".
- [12] 3GPP TS 38.509: "5GS; Special conformance testing functions for User Equipment (UE)".
- [13] 3GPP TS 38.521-1: "NR; User Equipment (UE) conformance specification; Radio transmission and reception; Part 1: Range 1 Standalone".
- [14] 3GPP TS 38.521-3: "NR; User Equipment (UE) conformance specification; Radio transmission and reception; Part 3: Range 1 and Range 2 Interworking operation with other radios".

- [15] 3GPP TS 38.521-4: "NR; User Equipment conformance specification; Radio transmission and reception; Part 4: Performance".
- [16] 3GPP TS 38.522: "NR; User Equipment (UE) conformance specification; Applicability of radio transmission, radio reception and radio resource management test cases".
- [17] 3GPP TS 38.533: "NR; User Equipment (UE) conformance specification; Radio resource management (RRM)".
- [18] 3GPP TS 38.300: "NR; Overall description; Stage 2".
- [19] 3GPP TS 38.331: "NR; Radio Resource Control (RRC); Protocol specification".
- [20] 3GPP TR 38.903: "NR; Derivation of test tolerances and measurement uncertainty for User Equipment (UE) conformance tests".
- [21] 3GPP TR 38.905: "NR; Derivation of test points for radio transmission and reception conformance test cases".
- [22] 3GPP TS 38.213: "NR; Physical layer procedures for control".
- [23] 3GPP TS 38.214: "NR; Physical layer procedures for data".
- [24] 3GPP TS 38.215: "NR; Physical layer measurements".
- [25] 3GPP TS 38.133: "NR; Requirements for support of radio resource management".
- [26] 3GPP TS 38.306: "NR; User Equipment (UE) radio access capabilities".
- [27] IEEE Std 149: "IEEE Standard Test Procedures for Antennas", IEEE.
- [28] 3GPP TS 38.321: "NR; Medium Access Control (MAC) protocol specification".

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## 3 Definitions, symbols and abbreviations

### 3.1 Definitions

For the purposes of the present document, the terms and definitions given in TR 21.905 [1] and the following apply. A term defined in the present document takes precedence over the definition of the same term, if any, in TR 21.905 [1].

**Aggregated Channel Bandwidth:** The RF bandwidth in which a UE transmits and receives multiple contiguously aggregated carriers.

**Beam correspondence:** the ability of the UE to select a suitable beam for UL transmission based on DL measurements with or without relying on UL beam sweeping.

**Carrier aggregation:** Aggregation of two or more component carriers in order to support wider transmission bandwidths.

**Carrier aggregation band:** A set of one or more operating bands across which multiple carriers are aggregated with a specific set of technical requirements.

**Carrier aggregation bandwidth class:** A class defined by the aggregated transmission bandwidth configuration and maximum number of component carriers supported by a UE.

**Carrier aggregation configuration:** A combination of CA operating band(s) and CA bandwidth class(es) supported by a UE.

NOTE: Carriers aggregated in each band can be contiguous or non-contiguous.

**Cumulative aggregated channel bandwidth:** The cumulative aggregated channel bandwidth is defined as the frequency band from the lowest edge of the lowest CC to the upper edge of the highest CC of all UL and DL configured CCs.

**EIRP(Link=TX beam peak direction, Meas=Link angle):** measurement of the EIRP of the UE such that the measurement angle is aligned with the beam peak direction within an acceptable measurement error uncertainty. EIRP (indicator to be measured) can be replaced by Frequency, EVM, carrier Leakage, In-band emission and OBW.

**EIRP(Link=Link angle, Meas=Link angle):** measurement of the UE such that the link angle is aligned with the measurement angle. EIRP (indicator to be measured) can be replaced by EIS, Frequency, EVM, carrier Leakage, In-band emission and OBW.

**EIRP(Link=Spherical coverage grid, Meas=Link angle):** measurement of the EIRP spherical coverage of the UE such that the EIRP link and measurement angles are aligned with the directions along the spherical coverage grid within an acceptable measurement error uncertainty. Alternatively, the spherical coverage grid can be replaced by the beam peak search grid as the results from the beam peak search can be re-used for spherical coverage.

**EIS (effective isotropic sensitivity):** sensitivity for an isotropic directivity device equivalent to the sensitivity of the discussed device exposed to an incoming wave from a defined AoA

NOTE 1: The sensitivity is the minimum received power level at which specific requirement is met.

NOTE 2: Isotropic directivity is equal in all directions (i.e. 0 dBi).

**EIS(Link=RX beam peak direction, Meas=Link angle):** measurement of the EIS of the UE such that the measurement angle is aligned with the RX beam peak direction within an acceptable measurement error uncertainty.

**Fallback group:** Group of carrier aggregation bandwidth classes for which it is mandatory for a UE to be able to fallback to lower order CA bandwidth class configuration. It is not mandatory for a UE to be able to fallback to lower order CA bandwidth class configuration that belongs to a different fallback group.

**IBM (Independent Beam Management):** A UE that supports inter-band CA with IBM selects its DL Rx beam(s) for all CCs in each configured band based on DL reference signals measurements made in that band.

**Inter-band carrier aggregation:** Carrier aggregation of component carriers in different operating bands.

NOTE: Carriers aggregated in each band can be contiguous or non-contiguous.

**Intra-band contiguous carrier aggregation:** Contiguous carriers aggregated in the same operating band.

**Intra-band non-contiguous carrier aggregation:** Non-contiguous carriers aggregated in the same operating band.

**Link angle:** a DL-signal AoA from the view point of the UE, as described in Annex N. If the beam lock function is used to lock the UE beam(s), the link angle can become any arbitrary AoA once the beam lock has been activated.

**Measurement angle:** the angle of measurement of the desired metric from the view point of the UE, as described in Annex N.

**radiated interface boundary:** operating band specific radiated requirements reference point where the radiated requirements apply.

**radiated requirements reference point:** for the RF measurement setup, the radiated requirements reference point is located at the centre of the quiet zone. From the UE perspective the reference point is the input of the UE antenna array.

**RX beam peak direction:** direction where the maximum total component of RSRP and thus best total component of EIS is found.

**Sub-block:** This is one contiguous allocated block of spectrum for transmission and reception by the same UE. There may be multiple instances of sub-blocks within an RF bandwidth.

**TRP(Link=TX beam peak direction, Meas=TRP grid):** measurement of the TRP of the UE such that the measurement angles are aligned with the directions of the TRP grid points within an acceptable measurement uncertainty while the link angle is aligned with the TX beam peak direction

NOTE: For requirements based on EIRP/EIS, the radiated interface boundary is associated to the far-field region.

**TX beam peak direction:** direction where the maximum total component of EIRP is found.

**UE transmission bandwidth configuration:** Set of resource blocks located within the UE channel bandwidth which may be used for transmitting or receiving by the UE.

**Vehicular UE:** A UE embedded in a vehicle.

## 3.2 Symbols

For the purposes of the present document, the following symbols apply:

$\Delta\text{EIRP}_{\text{BC}}$	The beam correspondence tolerance, where $\Delta\text{EIRP}_{\text{BC}} = \text{EIRP}_2 - \text{EIRP}_1$
$\Delta\text{F}_{\text{Global}}$	Granularity of the global frequency raster
$\Delta\text{F}_{\text{Raster}}$	Band dependent channel raster granularity
$\Delta\text{f}_{\text{OOB}}$	$\Delta$ Frequency of Out Of Band emission
$\Delta\text{MB}_{\text{P},n}$	Allowed relaxation to each, minimum peak EIRP and reference sensitivity due to support for multi-band operation, per band in a combination of supported bands
$\Delta\text{MB}_{\text{S},n}$	Allowed relaxation to each, EIRP spherical coverage and EIS spherical coverage due to support for multi-band operation, per band in a combination of supported bands
$\Delta_{\text{RB}}$	The starting frequency offset between the allocated RB and the measured non-allocated RB
$\Delta\text{R}_{\text{IB}}$	Allowed reference sensitivity relaxation due to support for inter-band CA operation
$\Delta\text{R}_{\text{IB},\text{P},n}$	Allowed relaxation to each, minimum peak EIRP and reference sensitivity due to support for inter-band CA operation, per band in a combination of supported bands
$\Delta\text{R}_{\text{IB},\text{S},n}$	Allowed relaxation to each, EIRP spherical coverage and EIS spherical coverage due to support for inter-band CA operation, per band in a combination of supported bands
$\sum\text{MB}_{\text{P}}$	Total allowed relaxation to each, minimum peak EIRP and reference sensitivity due to support for multi-band operation, for all bands in a combination of supported bands
$\sum\text{MB}_{\text{S}}$	Total allowed relaxation to each, EIRP spherical coverage and EIS spherical coverage due to support for multi-band operation, for all bands in a combination of supported bands
$\text{BW}_{\text{Channel}}$	Channel bandwidth
$\text{BW}_{\text{Channel\_CA}}$	Aggregated channel bandwidth, expressed in MHz.
$\text{BW}_{\text{GB}}$	$\max(\text{BW}_{\text{GB,Channel}(k)})$
$\text{BW}_{\text{GB,Channel}(k)}$	Minimum guardband defined in clause 5.3A.2 of carrier k
$\text{BW}_{\text{interferer}}$	Bandwidth of the interferer
$\text{Ceil}(x)$	Rounding upwards; $\text{ceil}(x)$ is the smallest integer such that $\text{ceil}(x) \geq x$
$\text{EIRP}_{\text{max}}$	The applicable maximum EIRP as specified in clause 6.2.1
$\text{EIRP}_1$	The measured total EIRP based on the beam the UE chooses autonomously (corresponding beam) to transmit in the direction of the incoming DL signal, which is based on beam correspondence without relying on UL beam sweeping
$\text{EIRP}_2$	The measured total EIRP based on the beam yielding highest EIRP in a given direction, which is based on beam correspondence with relying on UL beam sweeping
$F_{\text{C}}$	<i>RF reference frequency</i> for the carrier center on the channel raster, given in table 5.4.2.2-1
$F_{\text{C,block, high}}$	$F_{\text{C}}$ of the highest transmitted/received carrier in a sub-block.
$F_{\text{C,block, low}}$	$F_{\text{C}}$ of the lowest transmitted/received carrier in a sub-block.
$F_{\text{C, high}}$	The $F_{\text{C}}$ of the highest carrier, expressed in MHz.
$F_{\text{C, low}}$	The $F_{\text{C}}$ of the lowest carrier, expressed in MHz.
$F_{\text{DL\_high}}$	The highest frequency of the downlink <i>operating band</i>
$F_{\text{DL\_low}}$	The lowest frequency of the downlink <i>operating band</i>
$F_{\text{edge,block,high}}$	The upper sub-block edge, where $F_{\text{edge,block,high}} = F_{\text{C,block,high}} + F_{\text{offset, high}}$ .
$F_{\text{edge,block,low}}$	The lower sub-block edge, where $F_{\text{edge,block,low}} = F_{\text{C,block,low}} - F_{\text{offset, low}}$ .
$F_{\text{edge, high}}$	The upper edge of <i>Aggregated Channel Bandwidth</i> , expressed in MHz. $F_{\text{edge, high}} = F_{\text{C, high}} + F_{\text{offset, high}}$ .
$F_{\text{edge, low}}$	The lower edge of <i>Aggregated Channel Bandwidth</i> , expressed in MHz. $F_{\text{edge, low}} = F_{\text{C, low}} - F_{\text{offset, low}}$ .
$F_{\text{interferer}}$	Frequency of the interferer
$F_{\text{interferer (offset)}}$	Frequency offset of the interferer (between the center frequency of the interferer and the carrier frequency of the carrier measured)
$F_{\text{offset}}$	Frequency offset of the interferer (between the center frequency of the interferer and the closest edge of the carrier measured)
$\text{Floor}(x)$	Rounding downwards; $\text{floor}(x)$ is the greatest integer such that $\text{floor}(x) \leq x$
$F_{\text{OOB}}$	The boundary between the NR out of band emission and spurious emission domains
$F_{\text{offset, high}}$	Frequency offset from $F_{\text{C, high}}$ to the upper <i>UE RF Bandwidth edge</i> , or from $F_{\text{C,block, high}}$ to the upper sub-block edge
$F_{\text{offset, low}}$	Frequency offset from $F_{\text{C, low}}$ to the lower <i>UE RF Bandwidth edge</i> , or from $F_{\text{C,block, low}}$ to the lower sub-block edge
$F_{\text{REF}}$	RF reference frequency
$F_{\text{REF-Offs}}$	Offset used for calculating $F_{\text{REF}}$

$F_{UL\_high}$	The highest frequency of the uplink <i>operating band</i>
$F_{UL\_low}$	The lowest frequency of the uplink <i>operating band</i>
$F_{UL\_Meas}$	The sub-carrier frequency for which the equalizer coefficient is evaluated
$F_{center}$	The center frequency of an allocated block of PRBs
$GB_{channel}$	Minimum guardband defined in clause 5.3.3
$L_{CRB}$	Transmission bandwidth which represents the length of a contiguous resource block allocation expressed in units of resources blocks
$L_{CRB,Max}$	Maximum number of RB for a given Channel bandwidth and sub-carrier spacing
$Max()$	The largest of given numbers
$Min()$	The smallest of given numbers
$MPR_{f,c}$	Maximum output power reduction for carrier $f$ of serving cell $c$
$MPR_{narrow}$	Maximum output power reduction due to narrow PRB allocation
$MPR_{WT}$	Maximum power reduction due to modulation orders, transmit bandwidth configurations, waveform types
$NR_{ACLR}$	NR ACLR
$N_{RB}$	Transmission bandwidth configuration, expressed in units of resource blocks
$N_{RB,high}$	Transmission bandwidth configurations according to Table 5.3.2-1 for the highest assigned component carrier in clause 5.3A.1
$N_{RB,low}$	Transmission bandwidth configurations according to Table 5.3.2-1 for the lowest assigned component carrier in clause 5.3A.1
$N_{REF}$	NR Absolute Radio Frequency Channel Number (NR-ARFCN)
$N_{REF-Offs}$	Offset used for calculating $N_{REF}$
$n_{PRB}$	Physical resource block number
$P_{CMAX}$	The configured maximum UE output power
$P_{CMAX,f,c}$	The configured maximum UE output power for carrier $f$ of serving cell $c$
$P_{int}$	The intermediate power point as defined in Table 6.3.4.2.3-2
$P_{Interferer}$	Modulated mean power of the interferer
$P_{max}$	The maximum UE output power as specified in clause 6.2.1
$P_{min}$	The minimum UE output power as specified in clause 6.3.1
$P_{PowerClass}$	Nominal UE power class (i.e., no tolerance) as specified in clause 6.2.1
$P_{RB}$	The transmitted power per allocated RB, measured in dBm
$P_{TMAX,f,c}$	The measured total radiated power for carrier $f$ of serving cell $c$
$P_{UMAX}$	The measured configured maximum UE output power
$P_w$	Power of a wanted DL signal
$P-MPR_{f,c}$	The Power Management UE Maximum Power Reduction for carrier $f$ of serving cell $c$
$RB_{start}$	Indicates the lowest RB index of transmitted resource blocks
$SCS_{high}$	SCS for the highest assigned component carrier in clause 5.3A.1
$SCS_{low}$	SCS for the lowest assigned component carrier in clause 5.3A.1
$SS_{REF}$	SS block reference frequency position
$TRP_{max}$	The maximum TRP for the UE power class as specified in clause 6.2.1
$T(\Delta P)$	The tolerance $T(\Delta P)$ for applicable values of $\Delta P$ (values in dB)

### 3.3 Abbreviations

For the purposes of the present document, the abbreviations given in TR 21.905 [1] and the following apply. An abbreviation defined in the present document takes precedence over the definition of the same abbreviation, if any, in TR 21.905 [1].

ACLR	Adjacent Channel Leakage Ratio
ACS	Adjacent Channel Selectivity
AoA	Angle of Arrival
A-MPR	Additional Maximum Power Reduction
BCS	Bandwidth Combination Set
BPSK	Binary Phase-Shift Keying
BS	Base Station
BW	Bandwidth
BWP	Bandwidth Part
CA	Carrier Aggregation
CABW	Cumulative Aggregated Channel Bandwidth
CA_nX-nY	Inter-band CA of component carrier(s) in one sub-block within Band nX and component carrier(s) in one sub-block within Band nY where nX and nY are the applicable NR <i>operating band</i>
CC	Component Carrier

CDF	Cumulative Distribution Function
CP-OFDM	Cyclic Prefix-OFDM
CW	Continuous Wave
DFT-s-OFDM	Discrete Fourier Transform-spread-OFDM
DL	Downlink
DM-RS	Demodulation Reference Signal
DTX	Discontinuous Transmission
DUT	Device Under Test
EIRP	Effective Isotropic Radiated Power
EIS	Effective Isotropic Sensitivity
EVM	Error Vector Magnitude
FR	Frequency Range
FWA	Fixed Wireless Access
GSCN	Global Synchronization Channel Number
IBB	In-band Blocking
IBM	Independent Beam Management
IDFT	Inverse Discrete Fourier Transformation
ITU-R	Radio communication Sector of the International Telecommunication Union
MBW	Measurement bandwidth defined for the protected band
MPR	Allowed maximum power reduction
NR	New Radio
NR/5GC	NR connected to 5GC
NR-ARFCN	NR Absolute Radio Frequency Channel Number
NS	Network Signalling
OCNG	OFDMA Channel Noise Generator
OOB	Out-of-band
OTA	Over The Air
PRB	Physical Resource Block
P-MPR	Power Management Maximum Power Reduction
QAM	Quadrature Amplitude Modulation
RB	Resource Blocks
REFSENS	Reference Sensitivity
RF	Radio Frequency
RIB	Radiated Interface Boundary
RMS	Root Mean Square (value)
RSRP	Reference Signal Receiving Power
Rx	Receiver
SCS	Subcarrier Spacing
SEM	Spectrum Emission Mask
SRS	Sounding Reference Symbol
SS	Synchronization Symbol / System Simulator
TDD	Time Division Duplex
TPC	Transmission Power Control
TRP	Total Radiated Power
Tx	Transmitter
UE	User Equipment
UL	Uplink
UL MIMO	Uplink Multiple Antenna transmission
ULFPTx	Uplink Full Power Transmission

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## 4 General

### 4.1 Relationship between minimum requirements and test requirements

The TS 38.101-2 [3] is a Single-RAT specification for NR UE, covering RF characteristics and minimum performance requirements. Conformance to the TS 38.101-2 [3] is demonstrated by fulfilling the test requirements specified in the present document.

The Minimum Requirements given in TS 38.101-2 [3] make no allowance for measurement uncertainty (MU). The measurement uncertainty defines in TR 38.903 [20]. The present document defines test tolerances (TT). These test tolerances are individually calculated for each test. The test tolerances are used to relax the minimum requirements in the TS 38.101-2 [3] to create test requirements. For some requirements, including regulatory requirements, the test tolerance is set to zero.

The measurement results returned by the test system are compared - without any modification - against the test requirements as defined by various levels of "Shared Risk" principle as described below.

- a) Core specification value is not relaxed by any relaxation value ( $TT=0$ ). For each single measurement, the probability of a borderline good UE being judged as FAIL equals the probability of a borderline bad UE being judged as PASS.
  - Test tolerances equal to 0 ( $TT=0$ ) are considered in this specification.
- b) Core specification value is relaxed by a relaxation value ( $TT>0$ ). For each single measurement, the probability of a borderline bad UE being judged as PASS is greater than the probability of a borderline good UE being judged as FAIL.
  - Test tolerances lower than measurement uncertainty and greater than 0 ( $0 < TT < MU$ ) are considered in this specification.
  - Test tolerances high up to measurement uncertainty ( $TT = MU$ ) are considered in this specification which is also known as "Never fail a good DUT" principle.
- c) Core specification value is tightened by a stringent value ( $TT<0$ ). For each single measurement, the probability of a borderline good UE being judged as FAIL is greater than the probability of a borderline bad UE being judged as PASS.
  - Test tolerances lower than 0 ( $TT<0$ ) are not considered in this specification.

The "Never fail a good DUT" and the "Shared Risk" principles are defined in Recommendation ITU R M.1545 [6].

## 4.2 Applicability of minimum requirements

- a) In TS 38.101-2 [3] the Minimum Requirements are specified as general requirements and additional requirements. Where the Requirement is specified as a general requirement, the requirement is mandated to be met in all scenarios.
- b) For specific scenarios for which an additional requirement is specified, in addition to meeting the general requirement, the UE is mandated to meet the additional requirements.
- c) The spurious emissions power requirements are for the long-term average of the power. For the purpose of reducing measurement uncertainty it is acceptable to average the measured power over a period of time sufficient to reduce the uncertainty due to the statistical nature of the signal.
- d) All the requirements for intra-band contiguous and non-contiguous CA apply under the assumption of the same slot format indicated by TDD-UL-DL-ConfigurationCommon and TDD-UL-DL-ConfigurationDedicated in the PCell and SCells for NR/5GC.

For FR2 intra-band CA configurations with multiple FR2 sub-blocks, where at least one of the sub-blocks is a contiguous CA configuration:

- if the field *partialFR2-FallbackRX-Req* is not present, the UE shall meet all applicable UE RF requirements for the highest order CA configuration and all associated fallback CA configurations;
- if the field *partialFR2-FallbackRX-Req* is present, for each FR2 intra-band CA configuration with multiple sub-blocks that the UE indicates support for explicitly in UE capability signalling: the in-gap UE RF requirements in clauses 7.5A, 7.5D, 7.6A, 7.6D apply as the equivalent requirements for the associated fallback CA configurations with the same number of sub-blocks, where at least one of the sub-blocks consists of a contiguous CA configuration. The UE shall meet all applicable UE RF requirements for fallback CA configurations with a lesser number of sub-blocks;



- regardless of the field *partialFR2-FallbackRX-Req*, the UE shall meet all DL out-of-gap requirements for all lower order fallback CA configurations.

## 4.3 Specification suffix information

Unless stated otherwise the following suffixes are used for indicating at 2<sup>nd</sup> level clause, shown in Table 4.3-1.

**Table 4.3-1: Definition of suffixes**

Clause suffix	Variant
None	Single Carrier
A	Carrier Aggregation (CA)
B	Dual-Connectivity (DC)
C	Supplement Uplink (SUL)
D	UL MIMO
NOTE:	Suffix D in this specification represents either polarized UL MIMO or spatial UL MIMO. RF requirements are same. If UE supports both kinds of UL MIMO, then RF requirements only need to be verified under either polarized or spatial UL MIMO.

## 4.4 Test point analysis

The information on test point analysis and test point selection including number of test points for each test case is shown in TR 38.905 [21] clause 4.2.

## 4.5 Applicability and test coverage rules

The applicability and test coverage rules for NR/5GC and EN-DC capable devices shall include the following:

If a test case for a FR2 NR band in a device is tested in EN-DC mode for non-exceptional requirement as per TS 38.521-3 [14], it shall fulfil the coverage requirement for that test case for NR/5GC FR2 test requirements for that NR band and need not be retested.

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# 5 Operating bands and channel arrangement

## 5.1 General

The channel arrangements presented in this clause are based on the operating bands and channel bandwidths defined in the present release of specifications.

NOTE: Other operating bands and channel bandwidths may be considered in future releases.

Requirements throughout the RF specifications are in many cases defined separately for different frequency ranges (FR). The frequency ranges in which NR can operate according to this version of the specification are identified as described in Table 5.1-1.

**Table 5.1-1: Definition of frequency ranges**

Frequency range designation	Corresponding frequency range
FR1	410 MHz – 7125 MHz
FR2	24250 MHz – 52600 MHz

This test specification covers FR2 operating bands.

For the purpose of derivation of Maximum Test System Uncertainty (MTSU) in Annex F, the frequency range FR2 is further divided into sub-ranges as shown in Table 5.1-2. These FR2 sub-ranges are also referred to as part of definition of test tolerance within the individual test cases.

**Table 5.1-2: Definition of frequency sub-ranges**

Frequency sub-range designation	Corresponding frequency range
FR2a	$23.45 \text{ GHz} \leq f < 32.125 \text{ GHz}$
FR2b	$32.125 \text{ GHz} \leq f < 40.8 \text{ GHz}$
FR2c	$40.8 \text{ GHz} \leq f < 44.3 \text{ GHz}$
FR2d	$44.3 \text{ GHz} \leq f < 49.0 \text{ GHz}$

## 5.2 Operating bands

NR is designed to operate in the FR2 operating bands defined in Table 5.2-1.

**Table 5.2-1: NR operating bands in FR2**

Operating Band	Uplink (UL) operating band BS receive UE transmit	Downlink (DL) operating band BS transmit UE receive	Duplex Mode
	$F_{UL\_low} - F_{UL\_high}$	$F_{DL\_low} - F_{DL\_high}$	
n257	26500 MHz – 29500 MHz	26500 MHz – 29500 MHz	TDD
n258	24250 MHz – 27500 MHz	24250 MHz – 27500 MHz	TDD
n259	39500 MHz – 43500 MHz	39500 MHz – 43500 MHz	TDD
n260	37000 MHz – 40000 MHz	37000 MHz – 40000 MHz	TDD
n261	27500 MHz – 28350 MHz	27500 MHz – 28350 MHz	TDD

### 5.2A Operating bands for CA

#### 5.2A.1 Intra-band CA

NR intra-band contiguous and non-contiguous carrier aggregation is designed to operate in the operating bands defined in Table 5.2A.1-1, where all operating bands are within FR2.

**Table 5.2A.1-1: Intra-band contiguous and non-contiguous CA operating bands in FR2**

NR CA Band	NR Band (Table 5.2-1)
CA_n257	n257
CA_n260	n260
CA_n261	n261

#### 5.2A.2 Void

#### 5.2A.3 Inter-band CA

NR inter-band carrier aggregation is designed to operate in the operating bands defined in Table 5.2A.2-1, where all operating bands are within FR2.

Beam management type is according to UE capability declaration *IE beamManagementType-r16*. The requirements in the following clauses are only applicable to inter-band CA with IBM type.

**Table 5.2A.3-1: Inter-band CA operating bands in FR2**

NR CA Band	NR Band (Table 5.2-1)
CA_n260-n261	n260, n261

## 5.2D Operating bands for UL MIMO

NR UL MIMO is designed to operate in the operating bands defined in Table 5.2D-1.

**Table 5.2D-1: NR UL MIMO operating bands**

UL MIMO operating band (Table 5.2-1)
n257
n258
n259
n260
n261

## 5.3 UE Channel bandwidth

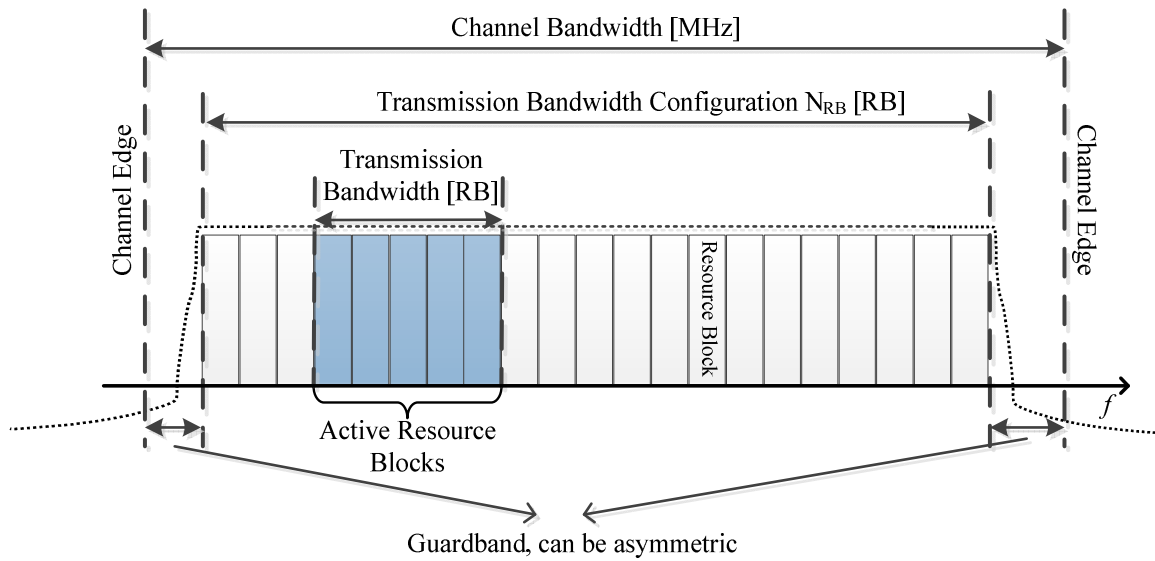
### 5.3.1 General

The UE channel bandwidth supports a single NR RF carrier in the uplink or downlink at the UE. From a BS perspective, different UE channel bandwidths may be supported within the same spectrum for transmitting to and receiving from UEs connected to the BS. Transmission of multiple carriers to the same UE (CA) or multiple carriers to different UEs within the BS channel bandwidth can be supported.

From a UE perspective, the UE is configured with one or more BWP / carriers, each with its own UE channel bandwidth. The UE does not need to be aware of the BS channel bandwidth or how the BS allocates bandwidth to different UEs.

The placement of the UE channel bandwidth for each UE carrier is flexible but can only be completely within the BS channel bandwidth.

The relationship between the channel bandwidth, the guardband and the transmission bandwidth configuration is shown in Figure 5.3.1-1.



**Figure 5.3.1-1: Definition of channel bandwidth and transmission bandwidth configuration for one NR channel**

### 5.3.2 Maximum transmission bandwidth configuration

The maximum transmission bandwidth configuration  $N_{RB}$  for each UE channel bandwidth and subcarrier spacing is specified in Table 5.3.2-1

**Table 5.3.2-1: Maximum transmission bandwidth configuration  $N_{RB}$**

SCS (kHz)	50 MHz	100 MHz	200 MHz	400 MHz
	$N_{RB}$	$N_{RB}$	$N_{RB}$	$N_{RB}$
60	66	132	264	N/A
120	32	66	132	264

### 5.3.3 Minimum guardband and transmission bandwidth configuration

The minimum guardband for each UE channel bandwidth and SCS is specified in Table 5.3.3-1.

**Table 5.3.3-1: Minimum guardband for each UE channel bandwidth and SCS (kHz)**

SCS (kHz)	50 MHz	100 MHz	200 MHz	400 MHz
60	1210	2450	4930	N/A
120	1900	2420	4900	9860

NOTE: The minimum guardbands have been calculated using the following equation:  $(BW_{Channel} \times 1000 \text{ (kHz)} - N_{RB} \times SCS \times 12) / 2 - SCS/2$ , where  $N_{RB}$  are from Table 5.3.2-1.

The minimum guardband of receiving BS SCS 240 kHz SS/PBCH block for each UE channel bandwidth is specified in table 5.3.3-2 for FR2.

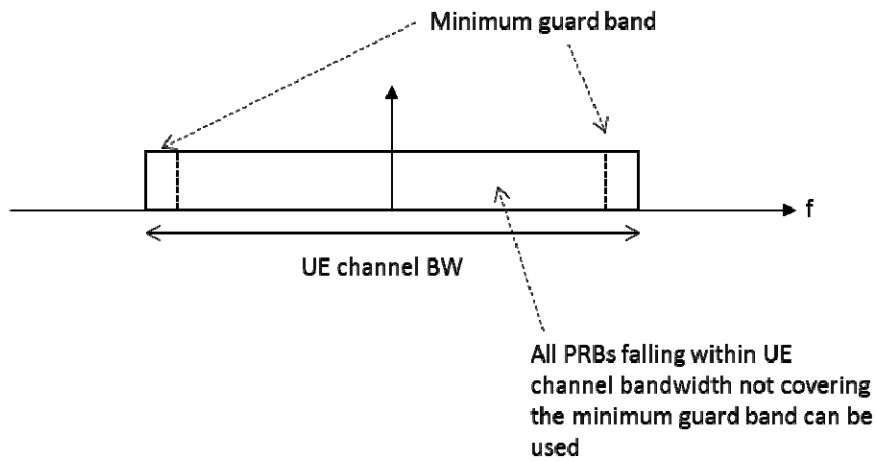
**Table: 5.3.3-2: Minimum guardband (kHz) of SCS 240 kHz SS/PBCH block**

SCS (kHz)	100 MHz	200 MHz	400 MHz
240	3800	7720	15560

NOTE: The minimum guardband in Table 5.3.3-2 is applicable only when the SCS 240 kHz SS/PBCH block is received adjacent to the edge of the UE channel bandwidth within which the SS/PBCH block is located.

**Figure 5.3.3-1: Void**

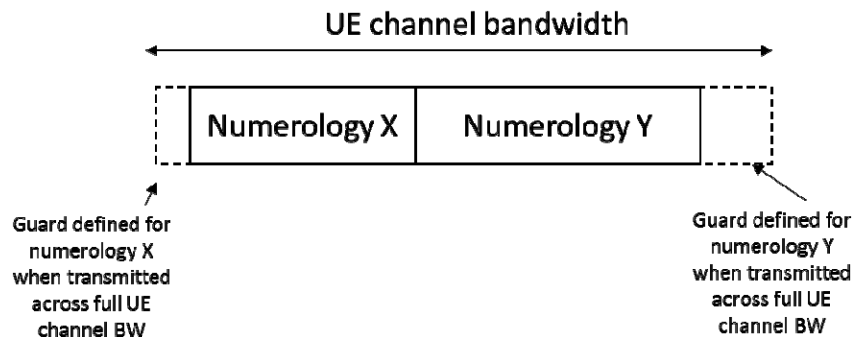
The number of RBs configured in any channel bandwidth shall ensure that the minimum guardband specified in this clause is met.



**Figure 5.3.3-2: UE PRB utilization**

In the case that multiple numerologies are multiplexed in the same symbol due to BS transmission of SSB, the minimum guardband on each side of the carrier is the guardband applied at the configured channel bandwidth for the numerology that is transmitted immediately adjacent to the guardband.

If multiple numerologies are multiplexed in the same symbol and the UE channel bandwidth is >200 MHz, the minimum guardband applied adjacent to 60 kHz SCS shall be the same as the minimum guardband defined for 120 kHz SCS for the same UE channel bandwidth.



**Figure 5.3.3-3: Guardband definition when transmitting multiple numerologies**

NOTE: Figure 5.3.3-3 is not intended to imply the size of any guard between the two numerologies. Inter-numerology guardband within the carrier is implementation dependent.

### 5.3.4 RB alignment

For each numerology, its common resource blocks are specified in clause 4.4.4.3 in [9], and the starting point of its transmission bandwidth configuration on the common resource block grid for a given channel bandwidth is indicated by an offset to “Reference point A” in the unit of the numerology. The *UE transmission bandwidth configuration* is indicated by the higher layer parameter *carrierBandwidth* [19] and will fulfil the minimum UE guardband requirement specified in clause 5.3.3.

### 5.3.5 Channel bandwidth per operating band

The requirements in this specification apply to the combination of channel bandwidths, SCS and operating bands shown in Table 5.3.5-1. The transmission bandwidth configuration in Table 5.3.2-1 shall be supported for each of the specified channel bandwidths. The channel bandwidths are specified for both the Tx and Rx path.

**Table 5.3.5-1: Channel bandwidths for each NR band**

Operating band / SCS / UE channel bandwidth					
Operating band	SCS kHz	50 MHz	100 MHz	200 MHz	400 <sup>2</sup> MHz
n257	60	Yes	Yes	Yes	N/A
	120	Yes	Yes	Yes	Yes
n258	60	Yes	Yes	Yes	N/A
	120	Yes	Yes	Yes	Yes
n259	60	Yes	Yes	Yes	N/A
	120	Yes	Yes	Yes	Yes
n260	60	Yes	Yes	Yes	N/A
	120	Yes	Yes	Yes	Yes
n261	60	Yes	Yes	Yes	N/A
	120	Yes	Yes	Yes	Yes

NOTE 1: For test configuration tables from the transmitter and receiver tests in Section 6 and 7 that refer to this table and indicate test SCS to use, if referenced SCS value is not supported by the UE in UL and/or DL, select the closest SCS supported by the UE in both UL and DL.

NOTE 2: This UE channel bandwidth is optional in this release of the specification.

## 5.3A UE Channel bandwidth for CA

### 5.3A.1 General

TBD

### 5.3A.2 Minimum guardband and transmission bandwidth configuration for CA

For intra-band contiguous carrier aggregation, *Aggregated Channel Bandwidth* and *Guard Bands* are defined as follows, see Figure 5.3A.2-1.

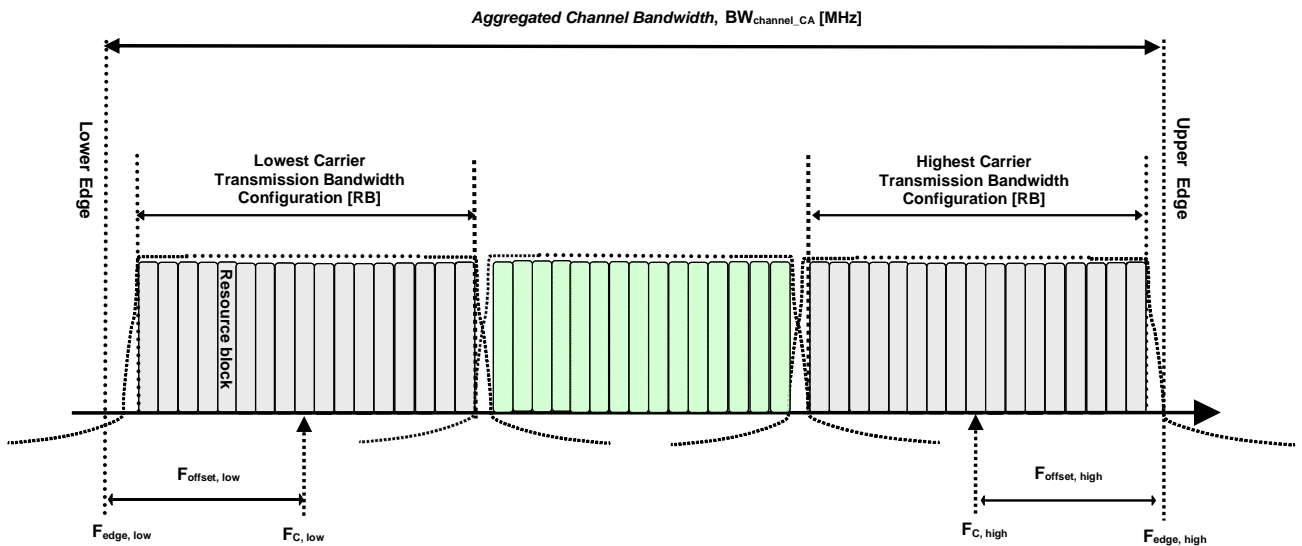


Figure 5.3A.2-1: Definition of *Aggregated Channel Bandwidth* for intra-band carrier aggregation

The *aggregated channel bandwidth*,  $BW_{Channel\_CA}$ , is defined as

$$BW_{Channel\_CA} = F_{edge,high} - F_{edge,low} \text{ (MHz)}.$$

The lower bandwidth edge  $F_{edge,low}$  and the upper bandwidth edge  $F_{edge,high}$  of the aggregated channel bandwidth are used as frequency reference points for transmitter and receiver requirements and are defined by

$$F_{edge,low} = F_{C,low} - F_{offset,low}$$

$$F_{edge,high} = F_{C,high} + F_{offset,high}$$

The lower and upper frequency offsets depend on the transmission bandwidth configurations of the lowest and highest assigned edge component carrier and are defined as

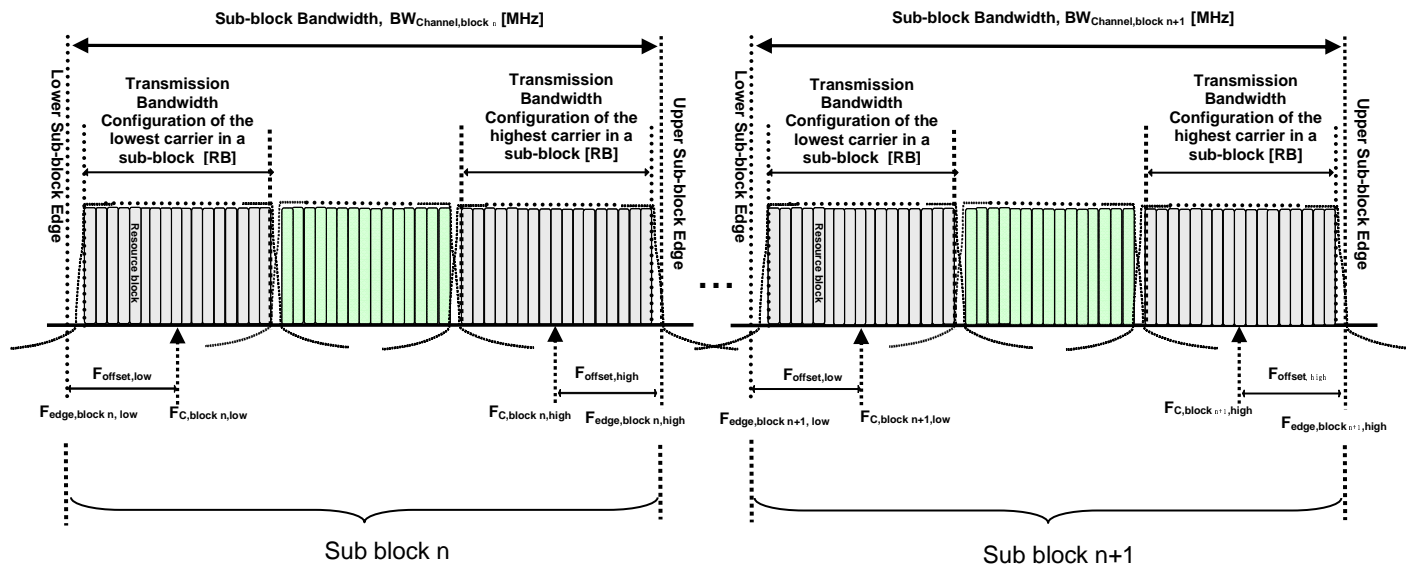
$$F_{offset,low} = (N_{RB,low} * 12 + 1) * SCS_{low} / 2 + BW_{GB} \text{ (MHz)}$$

$$F_{offset,high} = (N_{RB,high} * 12 - 1) * SCS_{high} / 2 + BW_{GB} \text{ (MHz)}$$

$$BW_{GB} = \max(BW_{GB,Channel(k)})$$

$N_{RB,low}$  and  $N_{RB,high}$  are the transmission bandwidth configurations according to Table 5.3.2-1 for the lowest and highest assigned component carrier,  $SCS_{low}$  and  $SCS_{high}$  are the sub-carrier spacing for the lowest and highest assigned component carrier respectively.  $SCS_{low}$ ,  $SCS_{high}$ ,  $N_{RB,low}$ ,  $N_{RB,high}$ , and  $BW_{GB,Channel(k)}$  use the largest  $\mu$  value among the subcarrier spacing configurations supported in the operating band for both of the channel bandwidths according to Table 5.3.5-1 and  $BW_{GB,Channel(k)}$  is the minimum guard band for carrier k according to Table 5.3.3-1 for the said  $\mu$  value.

For intra-band non-contiguous carrier aggregation *Sub-block Bandwidth* and *Sub-block edges* are defined as follows, see Figure 5.3A.2-2.



**Figure 5.3A.2-2: Definition of sub-block bandwidth for intra-band non-contiguous spectrum**

The lower sub-block edge of the Sub-block Bandwidth ( $BW_{Channel,block}$ ) is defined as

$$F_{edge,block,low} = F_{C,block,low} - F_{offset,low}$$

The upper sub-block edge of the Sub-block Bandwidth is defined as

$$F_{edge,block,high} = F_{C,block,high} + F_{offset,high}$$

The Sub-block Bandwidth,  $BW_{Channel,block}$ , is defined as follows:

$$BW_{Channel,block} = F_{edge,block,high} - F_{edge,block,low} \text{ (MHz)}$$

The lower and upper frequency offsets  $F_{offset,block,low}$  and  $F_{offset,block,high}$  depend on the transmission bandwidth configurations of the lowest and highest assigned edge component carriers within a sub-block and are defined as

$$F_{offset,block,low} = (N_{RB,low} * 12 + 1) * SCS_{low} / 2 + BW_{GB} \text{ (MHz)}$$

$$F_{offset,block,high} = (N_{RB,high} * 12 - 1) * SCS_{high} / 2 + BW_{GB} \text{ (MHz)}$$

$$BW_{GB} = \max(BW_{GB,Channel(k)})$$

where  $N_{RB,low}$  and  $N_{RB,high}$  are the transmission bandwidth configurations according to Table 5.3.2-1 for the lowest and highest assigned component carrier within a sub-block, respectively.  $SCS_{low}$ ,  $SCS_{high}$ ,  $N_{RB,low}$ ,  $N_{RB,high}$ , and  $BW_{GB,Channel(k)}$  use the largest  $\mu$  value among the subcarrier spacing configurations supported in the operating band for both of the channel bandwidths according to Table 5.3.5-1 and  $BW_{GB,Channel(k)}$  is the minimum guard band for carrier  $k$  according to Table 5.3.3-1 for the said  $\mu$  value.  $SCS_{low}$  and  $SCS_{high}$  are the sub-carrier spacing for the lowest and highest assigned component carrier within a sub-block, respectively.

The sub-block gap size between two consecutive sub-blocks  $W_{gap}$  is defined as

$$W_{gap} = F_{edge,block n+1,low} - F_{edge,block n,high} \text{ (MHz)}$$

### 5.3A.3 RB alignment with different numerologies for CA

TBD

### 5.3A.4 UE channel bandwidth per operating band for CA

For intra-band contiguous carrier aggregation, a carrier aggregation configuration is a single operating band supporting a carrier aggregation bandwidth class with associated bandwidth combination sets specified in clause 5.5A.1. For each



carrier aggregation configuration, requirements are specified for all aggregated channel bandwidths contained in a bandwidth combination set, UE can indicate support of several bandwidth combination sets per carrier aggregation configuration. The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier.

For intra-band non-contiguous downlink carrier aggregation, a carrier aggregation configuration is a single operating band supporting two or more sub-blocks, each supporting a carrier aggregation bandwidth class. The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier.

Frequency separation class specified in Table 5.3A.4-2 indicates the maximum frequency span between lower edge of lowest component carrier and upper edge of highest component carrier that UE can support per band in downlink or uplink respectively in non-contiguous intra-band operation.

The DL-only frequency spectrum is the width of UE frequency spectrum available to network to configure DL CCs only, and it extends on one-side of the bidirectional spectrum in contiguous manner with no frequency gap between the two. Frequency separation class for DL-only spectrum ( $F_{sd}$ ) specified in Table 5.3A.4-3 and is declared per band. The frequency separation class for DL-only spectrum ( $F_{sd}$ ) can be equal but not larger than the frequency separation (DL  $F_s$ ). The combined downlink spectrum (DL  $F_s + F_{sd}$ ) cannot exceed 2400 MHz. A UE may configure DL-only spectrum only if the combined downlink spectrum (DL  $F_s + F_{sd}$ ) exceeds 1400 MHz. When a UE configures DL-only spectrum, it shall not expect a CC to be configured across the boundary between bidirectional spectrum and DL-only spectrum UE can support respectively.

For inter-band carrier aggregation, a carrier aggregation configuration is a combination of operating bands, each supporting a carrier aggregation bandwidth class.

**Table 5.3A.4-1: CA bandwidth classes**

NR CA bandwidth class	Aggregated channel bandwidth	Number of contiguous CC	Fallback group
A	$BW_{Channel} \leq 400$ MHz	1	1,2,3,4
B	$400 \text{ MHz} < BW_{Channel\_CA} \leq 800$ MHz	2	1
C	$800 \text{ MHz} < BW_{Channel\_CA} \leq 1200$ MHz	3	
D	$200 \text{ MHz} < BW_{Channel\_CA} \leq 400$ MHz	2	2
E	$400 \text{ MHz} < BW_{Channel\_CA} \leq 600$ MHz	3	
F	$600 \text{ MHz} < BW_{Channel\_CA} \leq 800$ MHz	4	
G	$100 \text{ MHz} < BW_{Channel\_CA} \leq 200$ MHz	2	
H	$200 \text{ MHz} < BW_{Channel\_CA} \leq 300$ MHz	3	3
I	$300 \text{ MHz} < BW_{Channel\_CA} \leq 400$ MHz	4	
J	$400 \text{ MHz} < BW_{Channel\_CA} \leq 500$ MHz	5	
K	$500 \text{ MHz} < BW_{Channel\_CA} \leq 600$ MHz	6	
L	$600 \text{ MHz} < BW_{Channel\_CA} \leq 700$ MHz	7	
M	$700 \text{ MHz} < BW_{Channel\_CA} \leq 800$ MHz	8	
O	$100 \text{ MHz} \leq BW_{Channel\_CA} \leq 200$ MHz	2	4
P	$150 \text{ MHz} \leq BW_{Channel\_CA} \leq 300$ MHz	3	
Q	$200 \text{ MHz} \leq BW_{Channel\_CA} \leq 400$ MHz	4	
NOTE 1: Maximum supported component carrier bandwidths for fallback groups 1, 2, 3 and 4 are 400 MHz, 200 MHz, 100 MHz and 100 MHz respectively except for CA bandwidth class A.			
NOTE 2: It is mandatory for a UE to be able to fall back to lower order CA bandwidth class configuration within a fallback group. It is not mandatory for a UE to be able to fall back to lower order CA bandwidth class configuration that belongs to a different fallback group.			

**Table 5.3A.4-2: Frequency separation classes for non-contiguous intra-band operation**

Frequency separation class	Max. allowed frequency separation ( $F_s$ )
----------------------------	---

I	800 MHz
II	1200 MHz
III	F <sub>s</sub> 1400 MHz
IV	1000 MHz
V	1600 MHz
VI	1800 MHz
VII	2000 MHz
VIII	2200 MHz
IX	2400 MHz
X	400 MHz
XI	600 MHz
NOTE 1: F <sub>s</sub> values larger than 1400 MHz apply only to downlink frequency separation.	

Table 5.3A.4-3: Frequency separation classes for DL-only spectrum

Frequency separation class	Max. allowed frequency separation (F <sub>sd</sub> )
I	200 MHz
II	400 MHz
III	600 MHz
IV	800 MHz
V	1000 MHz
VI	1200 MHz

## 5.3D Channel bandwidth for UL MIMO

The requirements specified in clause 5.3 are applicable to UE supporting UL MIMO.

## 5.4 Channel arrangement

### 5.4.1 Channel spacing

#### 5.4.1.1 Channel spacing for adjacent NR carriers

The spacing between carriers will depend on the deployment scenario, the size of the frequency block available and the channel bandwidths. The nominal channel spacing between two adjacent NR carriers is defined as following:

For NR operating bands with 60 kHz channel raster,

Nominal Channel spacing =  $(BW_{\text{Channel}(1)} + BW_{\text{Channel}(2)})/2 + \{-20 \text{ kHz}, 0 \text{ kHz}, 20 \text{ kHz}\}$  for  $\Delta F_{\text{Raster}}$  equals to 60 kHz

Nominal Channel spacing =  $(BW_{\text{Channel}(1)} + BW_{\text{Channel}(2)})/2 + \{-40 \text{ kHz}, 0 \text{ kHz}, 40 \text{ kHz}\}$  for  $\Delta F_{\text{Raster}}$  equals to 120 kHz

where  $BW_{\text{Channel}(1)}$  and  $BW_{\text{Channel}(2)}$  are the channel bandwidths of the two respective NR carriers. The channel spacing can be adjusted depending on the channel raster to optimize performance in a particular deployment scenario.

### 5.4.2 Channel raster

#### 5.4.2.1 NR-ARFCN and channel raster

The global frequency raster defines a set of RF reference frequencies  $F_{\text{REF}}$ . The RF reference frequency is used in signalling to identify the position of RF channels, SS blocks and other elements.

The global frequency raster is defined for all frequencies from 0 to 100 GHz. The granularity of the global frequency raster is  $\Delta F_{\text{Global}}$ .

RF reference frequency is designated by an NR Absolute Radio Frequency Channel Number (NR-ARFCN) in the range [2016667...3279165] on the global frequency raster. The relation between the NR-ARFCN and the RF reference frequency  $F_{\text{REF}}$  in MHz is given by the following equation, where  $F_{\text{REF-Offs}}$  and  $N_{\text{REF-Offs}}$  are given in Table 5.4.2.1-1 and  $N_{\text{REF}}$  is the NR-ARFCN

$$F_{\text{REF}} = F_{\text{REF-Offs}} + \Delta F_{\text{Global}} (N_{\text{REF}} - N_{\text{REF-Offs}})$$

**Table 5.4.2.1-1: NR-ARFCN parameters for the global frequency raster**

Frequency range (MHz)	$\Delta F_{\text{Global}}$ (kHz)	$F_{\text{REF-Offs}}$ (MHz)	$N_{\text{REF-Offs}}$	Range of $N_{\text{REF}}$
24250 – 100000	60	24250.08	2016667	2016667 – 3279165

The *channel raster* defines a subset of RF reference frequencies that can be used to identify the RF channel position in the uplink and downlink. The RF reference frequency for an RF channel maps to a resource element on the carrier. For each operating band, a subset of frequencies from the global frequency raster are applicable for that band and forms a channel raster with a granularity  $\Delta F_{\text{Raster}}$ , which may be equal to or larger than  $\Delta F_{\text{Global}}$ .

The mapping between the channel raster and corresponding resource element is given in subclause 5.4.2.2. The applicable entries for each operating band are defined in subclause 5.4.2.3

### 5.4.2.2 Channel raster to resource element mapping

The mapping between the RF reference frequency on channel raster and the corresponding resource element is given in Table 5.4.2.2-1 and can be used to identify the RF channel position. The mapping depends on the total number of RBs that are allocated in the channel and applies to both UL and DL. The mapping must apply to at least one numerology supported by the UE.

**Table 5.4.2.2-1: Channel raster to resource element mapping**

	$N_{\text{RB}} \bmod 2 = 0$	$N_{\text{RB}} \bmod 2 = 1$
Resource element index $k$	0	6
Physical resource block number $n_{\text{PRB}}$	$n_{\text{PRB}} = \left\lfloor \frac{N_{\text{RB}}}{2} \right\rfloor$	$n_{\text{PRB}} = \left\lfloor \frac{N_{\text{RB}}}{2} \right\rfloor$

$k$ ,  $n_{\text{PRB}}$ ,  $N_{\text{RB}}$  are as defined in TS 38.211[9].

### 5.4.2.3 Channel raster entries for each operating band

The RF channel positions on the channel raster in each NR operating band are given through the applicable NR-ARFCN in Table 5.4.2.3-1, using the channel raster to resource element mapping in subclause 5.4.2.2.

- For NR operating bands with 60 kHz channel raster above 24 GHz,  $\Delta F_{\text{Raster}} = I \times \Delta F_{\text{Global}}$ , where  $I \in \{1, 2\}$ . Every  $I^{\text{th}}$  NR-ARFCN within the operating band are applicable for the channel raster within the operating band and the step size for the channel raster in Table 5.4.2.3-1 is given as  $\langle I \rangle$ .
- In frequency bands with two  $\Delta F_{\text{Raster}}$ , the higher  $\Delta F_{\text{Raster}}$  applies to channels using only the SCS that is equal to the higher  $\Delta F_{\text{Raster}}$  and the SSB SCS that is equal to or larger than the higher  $\Delta F_{\text{Raster}}$ .

**Table 5.4.2.3-1: Applicable NR-ARFCN per operating band**

Operating Band	$\Delta F_{\text{Raster}}$ (kHz)	Uplink and Downlink Range of $N_{\text{REF}}$ (First – $\langle \text{Step size} \rangle$ – Last)
n257	60	2054166 – $\langle 1 \rangle$ – 2104165
	120	2054167 – $\langle 2 \rangle$ – 2104165
n258	60	2016667 – $\langle 1 \rangle$ – 2070832
	120	2016667 – $\langle 2 \rangle$ – 2070831
n259	60	2270833 – $\langle 1 \rangle$ – 2337499
	120	2270833 – $\langle 2 \rangle$ – 2337499

n260	60	2229166 – <1> – 2279165
	120	2229167 – <2> – 2279165
n261	60	2070833 – <1> – 2084999
	120	2070833 – <2> – 2084999

## 5.4.3 Synchronization raster

### 5.4.3.1 Synchronization raster and numbering

The synchronization raster indicates the frequency positions of the synchronization block that can be used by the UE for system acquisition when explicit signalling of the synchronization block position is not present.

A global synchronization raster is defined for all frequencies. The frequency position of the SS block is defined as  $SS_{REF}$  with corresponding number GSCN. The parameters defining the  $SS_{REF}$  and GSCN for all the frequency ranges are in Table 5.4.3.1-1.

The resource element corresponding to the SS block reference frequency  $SS_{REF}$  is given in subclause 5.4.3.2. The synchronization raster and the subcarrier spacing of the synchronization block are defined separately for each band.

**Table 5.4.3.1-1: GSCN parameters for the global frequency raster**

Frequency range	SS block frequency position $SS_{REF}$	GSCN	Range of GSCN
24250 – 100000 MHz	24250.08 MHz + N * 17.28 MHz, N = 0: 4383	22256+ N	22256 – 26639

### 5.4.3.2 Synchronization raster to synchronization block resource element mapping

The mapping between the synchronization raster and the corresponding resource element of the SS block is given in Table 5.4.3.2-1.

**Table 5.4.3.2-1: Synchronization raster to SS block resource element mapping**

Resource element index $k$	120
----------------------------	-----

$k$  is the subcarrier number of SS/PBCH block defined in TS 38.211 [9] clause 7.4.3.1.

### 5.4.3.3 Synchronization raster entries for each operating band

The synchronization raster for each band is given in Table 5.4.3.3-1. The distance between applicable GSCN entries is given by the <Step size> indicated in Table 5.4.3.3-1.

**Table 5.4.3.3-1: Applicable SS raster entries per operating band**

NR Operating Band	SS Block SCS	SS Block pattern <sup>1</sup>	Range of GSCN (First – <Step size> – Last)
n257	120 kHz	Case D	22388 - <1> - 22558
	240 kHz	Case E	22390 - <2> - 22556
n258	120 kHz	Case D	22257 - <1> - 22443
	240 kHz	Case E	22258 - <2> - 22442
n259	120 kHz	Case D	23140 - <1> - 23369
	240 kHz	Case E	23142 - <2> - 23368
n260	120 kHz	Case D	22995 - <1> - 23166
	240 kHz	Case E	22996 - <2> - 23164
n261	120 kHz	Case D	22446 - <1> - 22492
	240 kHz	Case E	22446 - <2> - 22490

NOTE 1: SS Block pattern is defined in subclause 4.1 in TS 38.213 [22].

## 5.4A Channel arrangement for CA

### 5.4A.1 Channel spacing for CA

For intra-band contiguous carrier aggregation with two or more component carriers, the nominal channel spacing between two adjacent NR component carriers is defined as the following unless stated otherwise:

For NR operating bands with 60kHz channel raster:

$$\text{Nominal channel spacing} = \left\lceil \frac{BW_{\text{Channel}(1)} + BW_{\text{Channel}(2)} - 2|GB_{\text{Channel}(1)} - GB_{\text{Channel}(2)}|}{0.06 * 2^{n+1}} \right\rceil 0.06 * 2^n \text{ [MHz]}$$

with

$$n = \mu_0 - 2$$

where  $BW_{\text{Channel}(1)}$  and  $BW_{\text{Channel}(2)}$  are the channel bandwidths of the two respective NR component carriers according to Table 5.3.2-1 with values in MHz,  $\mu_0$  is the largest  $\mu$  value among the subcarrier spacing configurations supported in the operating band for both of the channel bandwidths according to Table 5.3.5-1, and  $GB_{\text{Channel}(i)}$  is the minimum guardband for channel bandwidth  $i$  according to Table 5.3.3-1 for the said  $\mu$  value, with  $\mu$  as defined in TS 38.211 [9].

The channel spacing for intra-band contiguous carrier aggregation can be adjusted to any multiple of sub-carrier spacing less than the nominal channel spacing to optimize performance in a particular deployment scenario.

For intra-band non-contiguous carrier aggregation, the channel spacing between two NR component carriers in different sub-blocks shall be larger than the nominal channel spacing defined in this subclause.

## 5.5 Configurations

### 5.5A Configurations for CA

#### 5.5A.1 Configurations for intra-band contiguous CA

**Table 5.5A.1-1: NR CA configurations, bandwidth combination sets, and fallback group defined for intra-band contiguous CA**

NR CA configuration	Uplink CA configurations	BW <sub>Channel</sub> (MHz)	BW <sub>Channel</sub> (MHz)	BW <sub>Channel</sub> (MHz)	BW <sub>Channel</sub> (MHz)	BW <sub>Channel</sub> (MHz)	BW <sub>Channel</sub> (MHz)	BW <sub>Channel</sub> (MHz)	BW <sub>Channel</sub> (MHz)	BW <sub>Channel</sub> (MHz)	Maximum aggregated BW (MHz)	BCS	Fallback group
CA_n257B	CA_n257B	50, 100, 200, 400	400								800	0	1
CA_n257D	CA_n257D	50, 100, 200,	200								400	0	2
CA_n257E	CA_n257E	50, 100, 200,	200	200							600	0	
CA_n257F	CA_n257F	50, 100, 200,	200	200	200						800	0	
CA_n257G	CA_n257G	50, 100	100								200	0	3
CA_n257H	CA_n257H	50, 100	100	100							300	0	
CA_n257I	CA_n257I	50, 100	100	100	100						400	0	
CA_n257J	CA_n257J	50, 100	100	100	100	100					500	0	
CA_n257K	CA_n257K	50, 100	100	100	100	100	100				600	0	
CA_n257L	CA_n257L	50, 100	100	100	100	100	100	100			700	0	
CA_n257M	CA_n257M	50, 100	100	100	100	100	100	100	100		800	0	
CA_n260B	CA_n260B	50, 100, 200, 400	400								800	0	1
CA_n260C	CA_n260B	50, 100, 200, 400	400	400							1200	0	
CA_n260D	CA_n260D	50, 100, 200	200								400	0	2
CA_n260E	CA_n260E	50, 100, 200	200	200							600	0	
CA_n260F	CA_n260F	50, 100, 200	200	200	200						800	0	
CA_n260G	CA_n260G	50, 100	100								200	0	3
CA_n260H	CA_n260H	50, 100	100	100							300	0	
CA_n260I	CA_n260I	50, 100	100	100	100						400	0	
CA_n260J	CA_n260J	50, 100	100	100	100	100					500	0	
CA_n260K	CA_n260K	50, 100	100	100	100	100	100				600	0	
CA_n260L	CA_n260L	50, 100	100	100	100	100	100	100			700	0	
CA_n260M	CA_n260M	50, 100	100	100	100	100	100	100	100		800	0	
CA_n260O	CA_n260O	50, 100	50, 100								200	0	4
CA_n260P	CA_n260P	50, 100	50, 100	50, 100							300	0	
CA_n260Q	CA_n260Q	50, 100	50, 100	50, 100	50, 100						400	0	
CA_n261B	CA_n261B	50, 100, 200, 400	400								800	0	1
CA_n261C	CA_n261B	50	400	400							850 <sup>1</sup>	0	
CA_n261D	CA_n261D	50, 100, 200	200								400	0	2
CA_n261E	CA_n261E	50, 100, 200	200	200							600	0	
CA_n261F	CA_n261F	50, 100, 200	200	200	200						800	0	
CA_n261G	CA_n261G	50, 100	100								200	0	3
CA_n261H	CA_n261H	50, 100	100	100							300	0	
CA_n261I	CA_n261I	50, 100	100	100	100						400	0	
CA_n261J	CA_n261J	50, 100	100	100	100	100					500	0	
CA_n261K	CA_n261K	50, 100	100	100	100	100	100				600	0	

NR CA configuration	Uplink CA configurations	BW <sub>Channel</sub> (MHz)	BW <sub>Channel</sub> (MHz)	BW <sub>Channel</sub> (MHz)	BW <sub>Channel</sub> (MHz)	BW <sub>Channel</sub> (MHz)	BW <sub>Channel</sub> (MHz)	BW <sub>Channel</sub> (MHz)	BW <sub>Channel</sub> (MHz)	BW <sub>Channel</sub> (MHz)	Maximum aggregated BW (MHz)	BCS	Fallback group
CA_n261L	CA_n261L	50, 100	100	100	100	100	100	100			700	0	4
CA_n261M	CA_n261M	50, 100	100	100	100	100	100	100	100		800	0	
CA_n261O	CA_n261O	50, 100	50, 100								200	0	
CA_n261P	CA_n261P	50, 100	50, 100	50, 100							300	0	
CA_n261Q	CA_n261Q	50, 100	50, 100,	50, 100	50, 100						400	0	

NOTE 1: Void.  
 NOTE 2: For the NR CA configuration with more than two component carries, the bandwidths in a BCS which may introduce combinations more than requested unintentionally should be listed in a row separately.

### 5.5A.2 Configurations for intra-band non-contiguous CA

Configurations listed in this clause apply to downlink carrier aggregation only.

NOTE: Sub-blocks belonging to a CA configuration can be in any order. In other words certain CA configuration acronym includes all sub-block arrangements which have exactly the same sub-block set. As an example, CA\_n260(2G-3O) denotes CA\_n260(2O-2G-O), CA\_n260(G-3O-G) etc. but these are not listed in tables separately.

**Table 5.5A.2-1: NR CA configurations with single CA bandwidth class defined for intra-band non-contiguous CA**

NR configuration	Uplink CA configurations	Sub-block	Sub-block	Sub-block	Sub-block	Sub-block	Sub-block	Sub-block	Sub-block	Sub-block	Σ(BW <sub>Channel,block</sub> ) (MHz)	BCS
CA_n257(2A)	-	n257A	n257A								800	0
CA_n260(2A)	-	n260A	n260A								800	0
CA_n260(3A)	-	n260A	n260A	n260A							1200	0
CA_n260(4A)	-	n260A	n260A	n260A	n260A						1600	0
CA_n261(2A)	-	n261A	n261A								800	0
CA_n261(3A)	-	n261A	n261A	n261A							800	0
CA_n261(4A)	-	n261A	n261A	n261A	n261A						800	0

NOTE 1: Void  
 NOTE 2: Void  
 NOTE 3: Void  
 NOTE 4: Channel bandwidth per operating band defined in Table 5.3.5-1.  
 NOTE 5: Void.  
 NOTE 6: Void.  
 NOTE 7: Σ(BW<sub>Channel,block</sub>) denotes the maximum total bandwidth from the summation of the sub-block bandwidths and shall be less than the bandwidth of the operating band.  
 NOTE 8: Unless otherwise stated, BCS0 is referred in each constituent CA configuration.

Table 5.5A.2-2: NR CA configurations with multiple CA bandwidth classes defined for intra-band non-contiguous CA

CA configuration	Uplink CA configurations	Sub-block	Sub-block	Sub-block	Sub-block	Sub-block	Sub-block	Sub-block	$\Sigma(BW_{\text{Channel,block}})$ (MHz)	BCS
CA_n260(A-I)	CA_n260I	n260A	CA_n260I						800	0
CA_n260(D-G)	CA_n260D CA_n260G	CA_n260D	CA_n260G						600	0
CA_n260(D-H)	CA_n260D CA_n260H	CA_n260D	CA_n260H						700	0
CA_n260(D-I)	CA_n260D CA_n260I	CA_n260D	CA_n260I						800	0
CA_n260(D-O)	CA_n260D CA_n260O	CA_n260D	CA_n260O						600	0
CA_n260(D-P)	CA_n260D CA_n260P	CA_n260D	CA_n260P						700	0
CA_n260(D-Q)	CA_n260D CA_n260Q	CA_n260D	CA_n260Q						800	0
CA_n260(E-O)	CA_n260E CA_n260O	CA_n260O	CA_n260E						800	0
CA_n260(E-P)	CA_n260E CA_n260P	CA_n260E	CA_n260P						800	0
CA_n260(E-Q)	CA_n260E CA_n260Q	CA_n260E	CA_n260Q						1000	0
CA_n260(G-I)	CA_n260G CA_n260I	CA_n260G	CA_n260I						600	0
CA_n261(D-G)	CA_n261D	CA_n261D	CA_n261D						600	0



	CA_n261G	1D	1G							
CA_n261(D-H)	CA_n261D CA_n261H	CA_n26 1D	CA_n26 1H						700	0
CA_n261(D-I)	CA_n261D CA_n261I	CA_n26 1D	CA_n26 1I						800	0
CA_n261(D-O)	CA_n261D CA_n261O	CA_n26 1D	CA_n26 1O						600	0
CA_n261(D-P)	CA_n261D CA_n261P	CA_n26 1D	CA_n26 1P						700	0
CA_n261(D-Q)	CA_n261D CA_n261Q	CA_n26 1D	CA_n26 1Q						800	0
CA_n261(E-O)	CA_n261E CA_n261O	CA_n26 1E	CA_n26 1O						800	0
CA_n261(E-P)	CA_n261E CA_n261P	CA_n26 1E	CA_n26 1P						800	0
CA_n261(E-Q)	CA_n261E CA_n261Q	CA_n26 1E	CA_n26 1Q						800 <sup>1</sup>	0

NOTE 1: Void

NOTE 2: Void

NOTE 3: Unless otherwise stated, BCS0 is referred to, in each constituent CA configuration.

NOTE 4: Void.

NOTE 5: Void.

NOTE 6: Void.

NOTE 7:  $\Sigma(BW_{\text{Channel,block}})$  denotes the maximum total bandwidth from the summation of the sub-block bandwidths and shall be less than the bandwidth of the operating band.

NOTE 8: Channel bandwidth per operating band is defined in Table 5.3.5-1.

NOTE 9: Configurations for intra-band contiguous CA are defined in Table 5.5A.1-1.

NOTE 10: Configurations for intra-band non-contiguous CA are defined in Table 5.5A.2-1.

### 5.5A.3 Configurations for inter-band CA

**Table 5.5A.3-1: NR CA configurations for inter-band CA**

NR CA configuration	Uplink CA configuration	NR Band	Channel bandwidth (MHz) (NOTE 1)				Bandwidth combination set
			50	100	200	400	
CA_n260A-n261A	-	n260	50	100	200	400	0
		n261	50	100	200	400	

NOTE 1: The SCS of each channel bandwidth for NR band refers to Table 5.3.5-1.

### 5.5D Configurations for UL MIMO

The requirements specified in subclause 5.5 are applicable to UE supporting UL MIMO.

## 6 Transmitter characteristics

### 6.1 General

**Editor's Note:** Test configurations/environments that require new spherical scan shall be included in test procedure section and identifying such scenarios is currently FFS and owned by RAN5.

Unless otherwise stated, the transmitter characteristics are specified over the air (OTA) with a single or multiple transmit chains.

Unless otherwise stated, for power class 3 UEs, the beam correspondence side condition for SSB and CSI-RS specified in subclause 6.6 shall apply to the transmission tests.

Transmitter requirements for CA operation apply only when the DMRS initialization parameters (including the case when the UE applies cell ID as DMRS scrambling ID) are different across all CCs. The UE may use higher MPR values outside this limitation.

Transmitter requirements for UL MIMO operation apply when the UE transmits on 2 ports on the same CDM group. The UE may use higher MPR values outside this limitation.

For Tx test cases the identified beam peak direction can be stored and reused for a device under test in various configurations/environments for the full duration of device testing as long as beam peak direction is the same.

Unless otherwise stated, Channel Bandwidth shall be prioritized in the selecting of test points. Subcarrier spacing shall be selected after Test Channel Bandwidth is selected.

Uplink RB allocations given in Table 6.1-1 and Table 6.1-2 are used throughout this section, unless otherwise stated by the test case.

The UE under test shall be pre-configured with UL Tx diversity schemes disabled to account for single polarization System Simulator (SS) in the test environment. The UE under test may transmit with dual polarization.

**Table 6.1-1: Common Uplink Configuration for PC2, PC3 and PC4**

Channel Bandwidth	SCS (kHz)	OFDM	RB allocation									Inner_Partial2_Left	Inner_Partial2_Right
			Outer_Full	Outer_1RB_Left	Outer_1RB_Right	Inner_Full (Note 1)	Inner_1RB_Left	Inner_1RB_Right	Inner_Partial_Left	Inner_Partial_Right			
50MHz	60	DFT-s	64@ 0	1@0	1@65	20@ 22 <sup>3</sup> 20@ 20 <sup>4</sup>	1@22 <sup>3</sup> 1@1 <sup>4</sup>	1@43 <sup>3</sup> 1@64 <sup>4</sup>	4@22 <sub>3</sub> 8@8 <sup>4</sup>	4@40 <sub>3</sub> 8@50 <sub>4</sub>	6@6 <sup>4</sup>	6@54 <sub>4</sub>	
		CP	66@ 0	1@0	1@65	22@ 22	1@22 <sup>3</sup> 1@1 <sup>4</sup>	1@43 <sup>3</sup> 1@64 <sup>4</sup>	4@22 <sub>3</sub> 7@7 <sup>4</sup>	4@40 <sub>3</sub> 7@52 <sub>4</sub>	6@6 <sup>4</sup>	6@54 <sub>4</sub>	
	120	DFT-s	32@ 0	1@0	1@31	10@ 11 <sup>3</sup> 10@ 10 <sup>4</sup>	1@11 <sup>3</sup> 1@1 <sup>4</sup>	1@21 <sup>3</sup> 1@30 <sup>4</sup>	4@11 <sub>3</sub> 4@4 <sup>4</sup>	4@18 <sub>3</sub> 4@24 <sub>4</sub>	3@3 <sup>4</sup>	3@26 <sub>4</sub>	
		CP	32@ 0	1@0	1@31	11@ 11 <sup>3</sup> 10@ 10 <sup>4</sup>	1@11 <sup>3</sup> 1@1 <sup>4</sup>	1@21 <sup>3</sup> 1@30 <sup>4</sup>	4@11 <sub>3</sub> 4@4 <sup>4</sup>	4@18 <sub>3</sub> 4@24 <sub>4</sub>	3@3 <sup>4</sup>	3@26 <sub>4</sub>	
100M Hz	60	DFT-s	128@ 0	1@0	1@13 1	40@ 44 <sup>3</sup> 40@	1@44 <sup>3</sup> 1@1 <sup>4</sup>	1@87 <sup>3</sup> 1@130 <sub>4</sub>	4@44 <sub>3</sub> 8@8 <sup>4</sup>	4@84 <sub>3</sub> 8@11	6@6 <sup>4</sup>	6@12 0 <sup>4</sup>	

200M Hz	120	CP	132@0	1@0	1@13 1	40 <sup>4</sup> 44@44	1@44 <sup>3</sup> 1@1 <sup>4</sup>	1@87 <sup>3</sup> 1@130 <sup>4</sup>	4@44 <sub>3</sub> 7@7 <sup>4</sup>	6 <sup>4</sup> 4@84 <sub>3</sub> 7@11 <sub>8</sub> <sup>4</sup>	6@6 <sup>4</sup>	6@12 0 <sup>4</sup>
		DFT-s	64@0	1@0	1@65	20@22 <sup>3</sup> 20@20 <sup>4</sup>	1@22 <sup>3</sup> 1@1 <sup>4</sup>	1@43 <sup>3</sup> 1@64 <sup>4</sup>	4@22 <sub>3</sub> 4@4 <sup>4</sup>	4@40 <sub>3</sub> 4@58 <sub>4</sub>	3@3 <sup>4</sup>	3@60 <sub>4</sub>
	60	DFT-s	256@0	1@0	1@26 3	81@88 <sup>3</sup> 81@81 <sup>4</sup>	1@88 <sup>3</sup> 1@1 <sup>4</sup>	1@175 <sub>3</sub> 1@262 <sub>4</sub>	4@88 <sub>3</sub> 8@8 <sup>4</sup>	4@17 <sub>2</sub> <sup>3</sup> 8@24 <sub>8</sub> <sup>4</sup>	6@6 <sup>4</sup>	6@25 2 <sup>4</sup>
		CP	264@0	1@0	1@26 3	88@88	1@88 <sup>3</sup> 1@1 <sup>4</sup>	1@175 <sub>3</sub> 1@262 <sub>4</sub>	4@88 <sub>3</sub> 7@7 <sup>4</sup>	4@17 <sub>2</sub> <sup>3</sup> 7@25 <sub>0</sub> <sup>4</sup>	6@6 <sup>4</sup>	6@25 2 <sup>4</sup>
	120	DFT-s	128@0	1@0	1@13 1	40@44 <sup>3</sup> 40@40 <sup>4</sup>	1@44 <sup>3</sup> 1@1 <sup>4</sup>	1@87 <sup>3</sup> 1@130 <sub>4</sub>	4@44 <sub>3</sub> 4@4 <sup>4</sup>	4@84 <sub>3</sub> 4@12 <sub>4</sub> <sup>4</sup>	3@3 <sup>4</sup>	3@12 6 <sup>4</sup>
		CP	132@0	1@0	1@13 1	44@44	1@44 <sup>3</sup> 1@1 <sup>4</sup>	1@87 <sup>3</sup> 1@130 <sub>4</sub>	4@44 <sub>3</sub> 4@4 <sup>4</sup>	4@84 <sub>3</sub> 4@12 <sub>4</sub> <sup>4</sup>	3@3 <sup>4</sup>	3@12 6 <sup>4</sup>
400M Hz	60	DFT-s	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A
		CP	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A
	120	DFT-s	256@0	1@0	1@26 3	64@66	1@66	1@197	4@66	4@19 <sub>4</sub>	N/A	N/A
		CP	264@0	1@0	1@26 3	66@66	1@66	1@197	4@66	4@19 <sub>4</sub>	N/A	N/A
<p>Note 1: RB allocation is left aligned within inner region.</p> <p>Note 2: Inner_Full allocation is selected as the largest RB allocation within Region 1 inner allocation defined in 6.2.2.3.3; Inner_Partial_Left and Inner_Partial_Right are selected as partial allocation within Region 1 inner allocation which are not impacted by MPR<sub>narrow</sub> defined in 6.2.2.3.3; Inner_Partial2_Left and Inner_Partial2_Right are selected as partial allocation within Region 1 inner allocation which are impacted by MPR<sub>narrow</sub> defined in 6.2.2.3.3 when MPR<sub>narrow</sub>=2 dB.</p> <p>Note 3: Applicable to Rel-15 PC3 devices which do not support <i>modifiedMPR-Behaviour</i> bit 0 capability (according to Annex P.1) and to Rel-15 and forward PC2 and PC4 devices..</p> <p>Note 4: Applicable to Rel-15 PC3 devices which supports <i>modifiedMPR-Behaviour</i> bit 0 capability (according to Annex P.1) and Rel-16 and forward PC3 devices.</p>												

Table 6.1-2: Common Uplink Configuration for PC1

Channel Bandwidth	SCS(k Hz)	OFDM	RB allocation								
			Outer_Full	Outer_1RB_Left	Outer_1RB_Right	Inner_Full_Region1	Inner_partial_Left_Region1	Inner_Partial_Right_Region1	Inner_Full_Region2	Inner_Partial_Left_Region2	Inner_Partial_Right_Region2
50MHz	60	DFT-s	64@0	1@0	1@65	20@22	16@2 <sub>2</sub>	16@28	32@16	16@8	16@42
		CP	66@0	1@0	1@65	22@22	16@2 <sub>2</sub>	16@28	33@16	16@8	16@42
	120	DFT-s	32@0	1@0	1@31	10@11	8@11	8@14	16@8	8@4	8@20

100MHz z	60	CP	32@0	1@0	1@31	11@11	8@11	8@14	16@8	8@4	8@20
		DFT-s	128@0	1@0	1@131	40@44	16@44	16@72	64@32	16@8	16@108
	120	CP	132@0	1@0	1@131	44@44	16@44	16@72	66@33	16@8	16@108
		DFT-s	64@0	1@0	1@65	20@23	8@22	8@36	32@16	8@4	8@54
200MHz z	60	DFT-s	256@0	1@0	1@263	81@88	16@88	16@160	128@64	16@8	16@240
		CP	264@0	1@0	1@263	88@88	16@88	16@160	132@66	16@8	16@240
	120	DFT-s	128@0	1@0	1@131	40@44	8@44	8@80	64@32	8@4	8@120
		CP	132@0	1@0	1@131	44@44	8@44	8@80	66@33	8@4	8@120
400MHz z	60	DFT-s	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A
		CP	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A
	120	DFT-s	256@0	1@0	1@263	64@66	8@66	8@190	128@64	8@4	8@252
		CP	264@0	1@0	1@263	66@66	8@66	8@190	132@66	8@4	8@252

Note 1: RB allocation is left aligned within inner region 1 or inner region 2 as defined in clause 6.2.2.3.1.  
Note 2: Inner\_Full allocation is selected as the largest RB allocation within Region 1 or Region 2 inner allocation defined in 6.2.2.3.1; Inner\_partial\_Left and Inner\_partial\_Right are selected as minimum allocation within Region 1 or Region 2 inner allocation which are not impacted by MPR<sub>narrow</sub> defined in 6.2.2.3.1.

## 6.2 Transmit power

### 6.2.1 UE maximum output power

#### 6.2.1.0 General

Note: Power class 1, 2, 3, and 4 are specified based on the assumption of certain UE types with specific device architectures. The UE types can be found in Table 6.2.1.0-1.

**Table 6.2.1.0-1: Assumption of UE Types**

UE Power class	UE type
1	Fixed wireless access (FWA) UE
2	Vehicular UE
3	Handheld UE
4	High power non-handheld UE

#### 6.2.1.1 UE maximum output power - EIRP and TRP

**Editor's note: The following aspects are either missing or not yet determined:**

- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.
- The test case is incomplete for band n259.

##### 6.2.1.1.1 Test purpose

To verify that the error of the UE maximum output power does not exceed the range prescribed by the specified nominal maximum output power and tolerance.

An excess maximum output power has the possibility to interfere to other channels or other systems. A small maximum output power decreases the coverage area.

## 6.2.1.1.2 Test applicability

This test case applies to all types of release 15 NR UEs and release 16 NR and forward UEs not supporting either CSI-RS based or SSB-based enhanced beam correspondence.

## 6.2.1.1.3 Minimum conformance requirements

## 6.2.1.1.3.1 UE maximum output power for power class 1

The following requirements define the maximum output power radiated by the UE for any transmission bandwidth within the channel bandwidth for non-CA configuration, unless otherwise stated. The period of measurement shall be at least one sub frame (1ms). The minimum output power values for EIRP are found in Table 6.2.1.1.3.1-1. The requirement is verified with the test metric of EIRP (Link=TX beam peak direction, Meas=Link angle).

**Table 6.2.1.1.3.1-1: UE minimum peak EIRP for power class 1**

Operating band	Min peak EIRP (dBm)
n257	40.0
n258	40.0
n260	38.0
n261	40.0
NOTE 1: Minimum peak EIRP is defined as the lower limit without tolerance	

The maximum output power values for TRP and EIRP are found in Table 6.2.1.1.3.1-2 below. The maximum allowed EIRP is derived from regulatory requirements [8]. The requirements are verified with the test metrics of TRP (Link=TX beam peak direction, Meas=TRP grid) in beam locked mode and EIRP (Link=TX beam peak direction, Meas=Link angle).

**Table 6.2.1.1.3.1-2: UE maximum output power limits for power class 1**

Operating band	Max TRP (dBm)	Max EIRP (dBm)
n257	35	55
n258	35	55
n260	35	55
n261	35	55

The minimum EIRP at the 85<sup>th</sup> percentile of the distribution of radiated power measured over the full sphere around the UE is defined as the spherical coverage requirement and is found in Table 6.2.1.1.3.1-3 below. The requirement is verified with the test metric of EIRP (Link=Spherical coverage grid, Meas=Link angle).

**Table 6.2.1.1.3.1-3: UE spherical coverage for power class 1**

Operating band	Min EIRP at 85%-tile CDF (dBm)
n257	32.0
n258	32.0
n260	30.0
n261	32.0
NOTE 1: Minimum EIRP at 85%-tile CDF is defined as the lower limit without tolerance	
NOTE 2: The requirements in this table are verified only under normal temperature conditions as defined in TS 38.508-1 [10] subclause 4.1.1.	

## 6.2.1.1.3.2 UE maximum output power for power class 2

The following requirements define the maximum output power radiated by the UE for any transmission bandwidth within the channel bandwidth for non-CA configuration, unless otherwise stated. The period of measurement shall be at least one sub frame (1ms). The minimum output power values for EIRP are found in Table 6.2.1.1.3.2-1. The requirement is verified with the test metric of EIRP (Link=TX beam peak direction, Meas=Link angle).

**Table 6.2.1.1.3.2-1: UE minimum peak EIRP for power class 2**

Operating band	Min peak EIRP (dBm)
n257	29
n258	29
n261	29
NOTE 1: Minimum peak EIRP is defined as the lower limit without tolerance	

The maximum output power values for TRP and EIRP are found in Table 6.2.1.1.3.2-2 below. The maximum allowed EIRP is derived from regulatory requirements [8]. The requirements are verified with the test metrics of TRP (Link=TX beam peak direction, Meas=TRP grid) in beam locked mode and EIRP (Link=TX beam peak direction, Meas=Link angle).

**Table 6.2.1.1.3.2-2: UE maximum output power limits for power class 2**

Operating band	Max TRP (dBm)	Max EIRP (dBm)
n257	23	43
n258	23	43
n261	23	43

The minimum EIRP at the 60<sup>th</sup> percentile of the distribution of radiated power measured over the full sphere around the UE is defined as the spherical coverage requirement and is found in Table 6.2.1.1.3.2-3 below. The requirement is verified with the test metric of EIRP (Link=Spherical coverage grid, Meas=Link angle).

**Table 6.2.1.1.3.2-3: UE spherical coverage for power class 2**

Operating band	Min EIRP at 60%-tile CDF (dBm)
n257	18.0
n258	18.0
n261	18.0
NOTE 1: Minimum EIRP at 60%-tile CDF is defined as the lower limit without tolerance	
NOTE 2: The requirements in this table are verified only under normal temperature conditions as defined in TS 38.508-1 [10] subclause 4.1.1.	

### 6.2.1.1.3.3 UE maximum output power for power class 3

The following requirements define the maximum output power radiated by the UE for any transmission bandwidth within the channel bandwidth for non-CA configuration, unless otherwise stated. The period of measurement shall be at least one sub frame (1ms). The minimum output power values for EIRP are found in Table 6.2.1.1.3.3-1. The requirement is verified with the test metric of total component of EIRP (Link=TX beam peak direction, Meas=Link angle). The requirement for the UE which supports a single FR2 band is specified in Table 6.2.1.1.3.3-1. The requirement for the UE which supports multiple FR2 bands is specified in both Table 6.2.1.1.3.3-1 and Table 6.2.1.1.3.3-4 or Table 6.2.1.1.3.3-5.

**Table 6.2.1.1.3.3-1: UE minimum peak EIRP for power class 3**

Operating band	Min peak EIRP (dBm)
n257	22.4
n258	22.4
n259	18.7
n260	20.6
n261	22.4
NOTE 1: Minimum peak EIRP is defined as the lower limit without tolerance	
NOTE 2: Void	

The maximum output power values for TRP and EIRP are found on the Table 6.2.1.1.3.3-2. The max allowed EIRP is derived from regulatory requirements [8]. The requirements are verified with the test metrics of TRP (Link=TX beam

peak direction, Meas=TRP grid) in beam locked mode and the total component of EIRP (Link=TX beam peak direction, Meas=Link angle).

**Table 6.2.1.1.3.3-2: UE maximum output power limits for power class 3**

Operating band	Max TRP (dBm)	Max EIRP (dBm)
n257	23	43
n258	23	43
n259	23	43
n260	23	43
n261	23	43

The minimum EIRP at the 50<sup>th</sup> percentile of the distribution of radiated power measured over the full sphere around the UE is defined as the spherical coverage requirement and is found in Table 6.2.1.1.3.3-3 below. The requirement is verified with the test metric of the total component of EIRP, as defined in [5] (Link=Spherical coverage grid, Meas=Link angle). The requirement for the UE which supports a single FR2 band is specified in Table 6.2.1.1.3.3-3. The requirement for the UE which supports multiple FR2 bands is specified in both Table 6.2.1.1.3.3-3 and Table 6.2.1.1.3.3-4 or Table 6.2.1.1.3.3-5.

**Table 6.2.1.1.3.3-3: UE spherical coverage for power class 3**

Operating band	Min EIRP at 50 <sup>th</sup> -tile CDF (dBm)
n257	11.5
n258	11.5
n259	5.8
n260	8
n261	11.5

NOTE 1: Minimum EIRP at 50 %-tile CDF is defined as the lower limit without tolerance  
NOTE 2: Void  
NOTE 3: The requirements in this table are verified only under normal temperature conditions as defined in TS 38.508-1 [10] subclause 4.1.1.

For the UEs that support multiple FR2 bands, minimum requirement for peak EIRP and EIRP spherical coverage in Tables 6.2.1.1.3.3-1 and 6.2.1.1.3.3-3 shall be decreased per band, respectively, by the peak EIRP relaxation parameter  $\Delta MB_{P,n}$  and EIRP spherical coverage relaxation parameter  $\Delta MB_{S,n}$ , as indicated in Table 6.2.1.1.3.3-4 to 6.2.1.1.3.3-5. For Rel-15 UE, each combination of supported bands  $\Delta MB_{P,n}$  and  $\Delta MB_{S,n}$  apply to each supported band  $n$ , such that the total relaxations,  $\sum MB_P$  and  $\sum MB_S$ , across all supported bands shall not exceed the total value indicated in Table 6.2.1.1.3.3-4.

**Table 6.2.1.1.3.3-4: UE multi-band relaxation factors for power class 3 (Rel-15)**

Supported bands	$\sum MB_P$ (dB)	$\sum MB_S$ (dB)
n257, n258	$\leq 1.3$	$\leq 1.25$
n257, n260	$\leq 1.0^3$	$\leq 0.75^3$
n258, n260	$\leq 1.0^3$	$\leq 0.75^3$
n258, n261	$\leq 1.0$	$\leq 1.25$
n260, n261	0.0	$\leq 0.75^2$
n257, n261	0.0	0.0
n257, n258, n260	$\leq 1.7^3$	$\leq 1.75^3$
n257, n258, n261	$\leq 1.7$	$\leq 1.75$
n257, n260, n261	$\leq 0.5^3$	$\leq 1.25^3$
n258, n260, n261	$\leq 1.5^3$	$\leq 1.25^3$
n257, n258, n260, n261	$\leq 1.7^3$	$\leq 1.75^3$

NOTE 1: The requirements in this table are applicable to UEs which support only the indicated bands.  
NOTE 2: For supported bands n260 + n261,  $\Delta MB_{S,n}$  is not applied for band n260.  
NOTE 3: For band n260, maximum applicable  $\Delta MB_{S,n}$  is 0.4 dB and  $\Delta MB_{P,n}$  is 0.75 dB.  
NOTE 4: For all bands except n260, the maximum applicable  $\Delta MB_{P,n}$  and  $\Delta MB_{S,n}$  is 0.75 dB.



**Table 6.2.1.1.3.3-5: UE multi-band relaxation factors for power class 3 (Rel-16 and forward)**

Band	$\Delta MB_{P,n}$ (dB)	$\Delta MB_{S,n}$ (dB)
n257	0.7 <sup>3</sup>	0.7 <sup>3</sup>
n258	0.6	0.7
n259	0.5	0.4
n260	0.5 <sup>1</sup>	0.4 <sup>1</sup>
n261	0.5 <sup>2,4</sup>	0.7 <sup>4</sup>
Note 1:	n260 peak and spherical relaxations are 0 dB for UE that exclusively supports n261+n260	
Note 2:	n261 peak relaxation is 0 dB for UE that exclusively supports n261+n260	
Note 3:	n257 peak and spherical relaxations are 0 dB for UE that exclusively supports n261+n257	
Note 4:	n261 peak and spherical relaxations are 0 dB for UE that exclusively supports n261+n257	

#### 6.2.1.1.3.4 UE maximum output power for power class 4

The following requirements define the maximum output power radiated by the UE for any transmission bandwidth within the channel bandwidth for non-CA configuration, unless otherwise stated. The period of measurement shall be at least one sub frame (1ms). The minimum output power values for EIRP are found in Table 6.2.1.1.3.4-1. The requirement is verified with the test metric of EIRP (Link=TX beam peak direction, Meas=Link angle).

**Table 6.2.1.1.3.4-1: UE minimum peak EIRP for power class 4**

Operating band	Min peak EIRP (dBm)
n257	34
n258	34
n260	31
n261	34
NOTE 1: Minimum peak EIRP is defined as the lower limit without tolerance	

The maximum output power values for TRP and EIRP are found in Table 6.2.1.1.3.4-2 below. The maximum allowed EIRP is derived from regulatory requirements [8]. The requirements are verified with the test metrics of TRP (Link=TX beam peak direction, Meas=TRP grid) in beam locked mode and EIRP (Link=TX beam peak direction, Meas=Link angle).

**Table 6.2.1.1.3.4-2: UE maximum output power limits for power class 4**

Operating band	Max TRP (dBm)	Max EIRP (dBm)
n257	23	43
n258	23	43
n260	23	43
n261	23	43

The minimum EIRP at the 20<sup>th</sup> percentile of the distribution of radiated power measured over the full sphere around the UE is defined as the spherical coverage requirement and is found in Table 6.2.1.1.3.4-3 below. The requirement is verified with the test metric of EIRP (Link=Spherical coverage grid, Meas=Link angle).

**Table 6.2.1.1.3.4-3: UE spherical coverage for power class 4**

Operating band	Min EIRP at 20%-tile CDF (dBm)
n257	25
n258	25
n260	19
n261	25
NOTE 1: Minimum EIRP at 20%-tile CDF is defined as the lower limit without tolerance	
NOTE 2: The requirements in this table are verified only under normal temperature conditions as defined in TS 38.508-1 [10] subclause 4.1.1.	

The normative reference for this requirement is TS 38.101-2 [3] clause 6.2.1.

#### 6.2.1.1.4 Test description

##### 6.2.1.1.4.1 Initial conditions

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, and channel bandwidths based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each channel bandwidth and subcarrier spacing, are shown in Table 6.2.1.1.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.2.1.1.4.1-1: Test Configuration Table**

Default Conditions					
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal, TL, TH		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1			Low range, Mid Range, High range		
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1			Lowest, 100 MHz, Highest		
Test SCS as specified in Table 5.3.5-1			120 kHz		
Test Parameters					
Test ID	ChBw	SCS	Downlink Configuration	Uplink Configuration	
		Default	-	Modulation	RB allocation (NOTE 1)
1	50			DFT-s-OFDM QPSK	Inner_Full for PC2, PC3 and PC4 Inner_Full_Region1 for PC1
2	100				
3	200				
4	400				
NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.					
NOTE 2: Void					

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement channels are set according to Table 6.2.1.1.4.1-1.
5. Propagation conditions are set according to Annex B.0
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.2.1.1.4.3

##### 6.2.1.1.4.2 Test procedure

1. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.2.1.1.4.1-1. Since the UL has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC. Messages to configure the appropriate uplink modulation in section 6.2.1.1.4.3.
2. Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.

3. Send continuously uplink power control "up" commands in every uplink scheduling information to the UE; allow at least 200 msec starting from the first TPC command in this step to ensure that the UE transmits at its maximum output power. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
4. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
5. Measure UE EIRP in the Tx beam peak direction in the channel bandwidth of the radio access mode according to the test configuration, which shall meet the requirements described in Tables 6.2.1.1.5-1 to 6.2.1.1.5-4. EIRP test procedure is defined in Annex K.1.3. The measuring duration is one active uplink subframe. EIRP is calculated considering both polarizations, theta and phi.
6. Measure TRP of the transmitted signal for the assigned NR channel with a rectangular measurement filter with bandwidths according to Table 6.5.2.3.5-1. Total radiated power is measured according to TRP measurement procedure defined in Annex K.1.7 and measurement grid specified in Annex M.4. TRP is calculated considering both polarizations, theta and phi.
7. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

#### 6.2.1.1.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with TRANSFORM\_PRECODER\_ENABLED condition in Table 4.6.3-118 PUSCH-Config.

#### 6.2.1.1.5 Test requirement

The EIRP derived in step 5 and TRP derived in step 6 shall not exceed the values specified in Table 6.2.1.1.5-1 to Table 6.2.1.1.5-4.

**Table 6.2.1.1.5-1: UE maximum output test requirements for power class 1**

Operating band	Max TRP (dBm)	Max EIRP (dBm)	Min peak EIRP (dBm)
n257	35+TT	55	40.0-TT
n258	35+TT	55	40.0-TT
n260	35+TT	55	38.0-TT
n261	35+TT	55	40.0-TT

**Table 6.2.1.1.5-1a: Test Tolerance (Max TRP for Power class 1)**

Test Metric	FR2a	FR2b
Max device size $\leq$ 30 cm	[2,73] dB, NTC TBD dB, ETC	TBD dB, NTC TBD dB, ETC

**Table 6.2.1.1.5-1b: Test Tolerance (Min peak EIRP for Power class 1)**

Test Metric	FR2a	FR2b
Max device size $\leq$ 30 cm	[3,12] dB, NTC TBD dB, ETC	TBD dB, NTC TBD dB, ETC

**Table 6.2.1.1.5-2: UE maximum output test requirements for power class 2**

Operating band	Max TRP (dBm)	Max EIRP (dBm)	Min peak EIRP (dBm)
n257	23+TT	43	29-TT
n258	23+TT	43	29-TT
n260			
n261	23+TT	43	29-TT

**Table 6.2.1.1.5-3: UE maximum output test requirements for power class 3 for single band UE**

Operating band	Max TRP (dBm)	Max EIRP (dBm)	Min peak EIRP (dBm)
n257	23+TT	43	22.4-TT
n258	23+TT	43	22.4-TT
n260	23+TT	43	20.6-TT
n261	23+TT	43	22.4-TT

**Table 6.2.1.1.5-3a: UE maximum output test requirements for power class 3 for multi-band UE (Rel-15)**

ID	Supported FR2 bands set	Test requirement (dB) (Note 1)				Maximum sum of MB <sub>p</sub> , ΣMB <sub>p</sub> (dB) (Note 3)	Comments
		n257	n258	n260	n261		
1	n257, n258	22.4-TT-MB <sub>p</sub>	22.4-TT-MB <sub>p</sub>			1.3	Maximum 0.75 dB relaxation allowed for each band
2	n257, n260	22.4-TT-MB <sub>p</sub>		20.6-TT-MB <sub>p</sub>		1.0	Maximum 0.75 dB relaxation allowed for each band
3	n258, n260		22.4-TT-MB <sub>p</sub>	20.6-TT-MB <sub>p</sub>		1.0	Maximum 0.75 dB relaxation allowed for each band
4	n258, n261		22.4-TT-MB <sub>p</sub>		22.4-TT-MB <sub>p</sub>	1.0	Maximum 0.75 dB relaxation allowed for each band
5	n260, n261			20.6-TT	22.4-TT	0.0	No relaxation factor allowed
6	n257, n258, n260	22.4-TT-MB <sub>p</sub>	22.4-TT-MB <sub>p</sub>	20.6-TT-MB <sub>p</sub>		1.7	Maximum 0.75 dB relaxation allowed for each band
7	n257, n258, n261	22.4-TT-MB <sub>p</sub>	22.4-TT-MB <sub>p</sub>		22.4-TT-MB <sub>p</sub>	1.7	Maximum 0.75 dB relaxation allowed for each band
8	n257, n260, n261	22.4-TT-MB <sub>p</sub>		20.6-TT-MB <sub>p</sub>	22.4-TT-MB <sub>p</sub>	0.5	Maximum 0.75 dB relaxation allowed for each band
9	n258, n260, n261		22.4-TT-MB <sub>p</sub>	20.6-TT-MB <sub>p</sub>	22.4-TT-MB <sub>p</sub>	1.5	Maximum 0.75 dB relaxation allowed for each band
10	n257, n258, n260, n261	22.4-TT-MB <sub>p</sub>	22.4-TT-MB <sub>p</sub>	20.6-TT-MB <sub>p</sub>	22.4-TT-MB <sub>p</sub>	1.7	Maximum 0.75 dB relaxation allowed for each band
11	n257, n261	22.4-TT			22.4-TT	0.0	No relaxation factor allowed

Note 1: MB<sub>p</sub> is the Multi-band Relaxation factor declared by the UE for the tested band in table A.4.3.9-2 of TS38.508-2 [11]. This declaration shall fulfil the requirements in Table 6.2.1.1.3.3-4.

Note 2: All UE supported bands needs to be tested to ensure the multi-band relaxation declaration is compliant

Note 3: Max allowed sum of MB<sub>p</sub> over all supported FR2 bands as defined in clause 6.2.1.1.3.3.

Note 4: For a Rel-15 UE supporting FR2 bands set not defined in Table 6.2.1.1.3.3-4, Table 6.2.1.1.5-3d applies.

**Table 6.2.1.1.5-3b: Test Tolerance (Max TRP for Power class 3)**

Test Metric	FR2a	FR2b
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Max device size ≤ 30 cm	2.65 dB, NTC 2.82 dB, ETC	2.77 dB, NTC 2.94 dB, ETC
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**Table 6.2.1.1.5-3c: Test Tolerance (Min peak EIRP for Power class 3)**

Test Metric	FR2a	FR2b
Max device size ≤ 30 cm	2.87 dB, NTC 3.04 dB, ETC	2.87 dB, NTC 3.04 dB, ETC

**Table 6.2.1.1.5-3d: UE maximum output test requirements for power class 3 (Rel-16 and forward)**

ID	FR2 bands/set	Test requirement (dB) (Note 1)					Comments
		n257	n258	n259	n260	n261	
1	n257	22.4-TT-ΔMB <sub>P,n</sub>					
2	n258		22.4-TT-ΔMB <sub>P,n</sub>				
3	n259			18.7-TT-ΔMB <sub>P,n</sub>			
4	n260				20.6-TT-ΔMB <sub>P,n</sub>		
5	n261					22.4-TT-ΔMB <sub>P,n</sub>	
6	n257, n261	22.4-TT				22.4-TT	ΔMB <sub>P,n</sub> relaxation is 0 dB
7	n260, n261				20.6-TT	22.4-TT	ΔMB <sub>P,n</sub> relaxation is 0 dB

Note 1: ΔMB<sub>P,n</sub> is the Multi-band Relaxation factor for the tested band. This shall fulfil the requirements in Table 6.2.1.1.3.3-5.

**Table 6.2.1.1.5-4: UE maximum output power test requirements for power class 4**

Operating band	Max TRP (dBm)	Max EIRP (dBm)	Min peak EIRP (dBm)
n257	23+TT	43	34-TT
n258	23+TT	43	34-TT
n260	23+TT	43	31-TT
n261	23+TT	43	34-TT

**6.2.1.1\_1 UE maximum output power - EIRP and TRP (Rel16 and forward)**

Editor’s note: This clause is incomplete. The following aspects are either missing or not yet determined:

- Same as in 6.2.1.1

**6.2.1.1\_1.1 Test purpose**

Same as 6.2.1.1.1

**6.2.1.1\_1.2 Test applicability**

This test case applies to all types of NR UEs release 16 and forward supporting either SSB-based or CSI-RS based enhanced beam correspondence.

**6.2.1.1\_1.3 Minimum conformance requirements**

Same as 6.2.1.1.3 except for the following section on multi-band relaxation factors:

For the Release 16 UEs that support multiple FR2 bands, minimum requirement for peak EIRP and EIRP spherical coverage in Tables 6.2.1.1\_1.3.3-1 and 6.2.1.1\_1.3.3-3 shall be decreased per band, respectively, by the peak EIRP relaxation parameter ΔMB<sub>P,n</sub> and EIRP spherical coverage relaxation parameter ΔMB<sub>S,n</sub>, as indicated in Table 6.2.1.1\_1.3-1.

**Table 6.2.1.1\_1.3.1-1: UE multi-band relaxation factors for power class 3 (Rel-16 and forward)**

Band	$\Delta MB_{P,n}$ (dB)	$\Delta MB_{S,n}$ (dB)
n257	0.7 <sup>3</sup>	0.7 <sup>3</sup>
n258	0.6	0.7
n259	0.5	0.4
n260	0.5 <sup>1</sup>	0.4 <sup>1</sup>
n261	0.5 <sup>2,4</sup>	0.7 <sup>4</sup>
Note 1:	n260 peak and spherical relaxations are 0 dB for UE that exclusively supports n261+n260	
Note 2:	n261 peak relaxation is 0 dB for UE that exclusively supports n261+n260	
Note 3:	n257 peak and spherical relaxations are 0 dB for UE that exclusively supports n261+n257	
Note 4:	n261 peak and spherical relaxations are 0 dB for UE that exclusively supports n261+n257	

6.2.1.1\_1.4 Test description

6.2.1.1\_1.4.1 Initial conditions

Same as 6.2.1.1.4.1 and 6.6.1.4.3

6.2.1.1\_1.4.2 Test procedure

The following cases are tested depending on UE capability:

1. Test procedure if *beamCorrespondenceWithoutUL-BeamSweeping* is NOT supported and *beamCorrespondenceSSB-based-r16* is supported:
  - 1.1 Same as 6.2.1.1.4.2 with the exception that step 6 is skipped and measurements shall be carried out using only side conditions defined in Table 6.6.1.3.3.1.1-1
  - 1.2 Skip to Step 7.
2. Test procedure if *beamCorrespondenceWithoutUL-BeamSweeping* is NOT supported, and *beamCorrespondenceCSI-RS-based-r16* is supported
  - 2.1 Same as 6.2.1.1.4.2 with the exception that step 6 is skipped and measurements shall be carried out using only side conditions defined in Table 6.6.2.3.3-1
  - 2.2 Skip to Step 7.
3. Test procedure if *beamCorrespondenceWithoutUL-BeamSweeping* is NOT supported, *beamCorrespondenceCSI-RS-based-r16* and *beamCorrespondenceSSB-based-r16* are supported
  - 3.1 Same as 6.2.1.1.4.2 with the exception that step 6 is skipped and measurements shall be carried out using only side conditions defined in Table 6.6.1.3.3.1.1-1.
  - 3.2 Repeat 6.2.1.1.4.2 with step 6 skipped with Tx Beam Peak direction determined using the side conditions in Table 6.6.2.3.3-1 Record the verdict (as this result will not be compared to test requirements in this test case but in a different one)..3.3 Skip to Step 7.
4. Test procedure if *beamCorrespondenceWithoutUL-BeamSweeping* is supported and *beamCorrespondenceSSB-based-r16* is supported:
  - 4.1 Same as 6.2.1.1.4.2 with the exception that step 6 is skipped and measurements shall be carried out using only side conditions defined in Table 6.6.1.3.3.1.1-1.
  - 4.2 Skip to Step 7.
5. Test procedure if *beamCorrespondenceWithoutUL-BeamSweeping* is supported and *beamCorrespondenceCSI-RS-based-r16* is supported:

5.1 Same as 6.2.1.1.4.2 with the exception that step 6 is skipped and measurements shall be carried out using only side conditions defined in Table 6.6.2.3.3-1

5.2 Skip to Step 7

6. Test procedure if beamCorrespondenceWithoutUL-BeamSweeping is supported, beamCorrespondenceCSI-RS-based-r16 and beamCorrespondenceSSB-based-r16 is supported

6.1 Same as 6.2.1.1.4.2 with the exception that step 6 is skipped and measurements shall be carried out using only side conditions defined in Table 6.6.1.3.3.1.1-1.

6.2 Repeat 6.2.1.1.4.2 with step 6 skipped with Tx Beam Peak direction determined using the side conditions in Table 6.6.2.3.3-1. Record the verdict (as this result will not be compared to test requirements in this test case but in a different one).

7. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

6.2.1.1\_1.4.3 Message contents

Same as 6.2.1.1\_1.4.3

6.2.1.1\_1.5 Test requirement

Same as 6.2.1.1\_1.5 except for Table 6.2.1.1\_1.5\_1

**Table 6.2.1.1\_1.5-1: UE maximum output test requirements for power class 3 (Rel-16 and forward)**

ID	FR2 bands/set	Test requirement (dB) (Note 1)					Comments
		n257	n258	n259	n260	n261	
1	n257	22.4-TT- $\Delta MB_{P,n}$					
2	n258		22.4-TT- $\Delta MB_{P,n}$				
3	n259			18.7-TT- $\Delta MB_{P,n}$			
4	n260				20.6-TT- $\Delta MB_{P,n}$		
5	n261					22.4-TT- $\Delta MB_{P,n}$	
6	n257, n261	22.4-TT- $\Delta MB_{P,n}$				22.4-TT- $\Delta MB_{P,n}$	$\Delta MB_{P,n}$ relaxation is 0 dB
7	n260, n261				20.6-TT- $\Delta MB_{P,n}$	22.4-TT- $\Delta MB_{P,n}$	$\Delta MB_{P,n}$ relaxation is 0 dB

Note 1:  $\Delta MB_{P,n}$  is the Multi-band Relaxation factor for the tested band. This shall fulfil the requirements in Table 6.2.1.1.3.3-5.

6.2.1.2 UE maximum output power - Spherical coverage

Editor’s note: The following aspects are either missing or not yet determined:

- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.

- The test case is incomplete for band n259.

6.2.1.2.1 Test purpose

To verify that the spatial coverage of the UE in expected directions is acceptable.

6.2.1.2.2 Test applicability

This test case applies to all types of release 15 NR UEs and release 16 and forward NR UEs not supporting either CSI-RS based or SSB-based enhanced beam correspondence.

### 6.2.1.2.3 Minimum conformance requirements

Minimum conformance requirements are defined in clause 6.2.1.1.3.

### 6.2.1.2.4 Test description

#### 6.2.1.2.4.1 Initial conditions

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, and channel bandwidths based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each channel bandwidth and subcarrier spacing, are shown in Table 6.2.1.2.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.2.1.2.4.1-1: Test Configuration Table**

Default Conditions					
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1				Low range, Mid Range, High range	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1				Lowest, Highest	
Test SCS as specified in Table 5.3.5-1				120 kHz	
Test Parameters					
Test ID	ChBw	SCS	Downlink Configuration	Uplink Configuration	
		Default	-	Modulation	RB allocation (NOTE 1)
1	50			DFT-s-OFDM QPSK	Inner_Full for PC2, PC3 and PC4 Inner_Full_Region1 for PC1
2	100				
3	200				
4	400				
NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.					

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement channels are set according to Table 6.2.1.2.4.1-1.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.2.1.2.4.3

#### 6.2.1.2.4.2 Test procedure

1. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.2.1.2.4.1-1. Since the UL has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC. Messages to configure the appropriate uplink modulation in section 6.2.1.2.4.3.
2. Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.



3. Send continuously uplink power control "up" commands in every uplink scheduling information to the UE; allow at least 200 msec to ensure that the UE transmits at its maximum output power. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
4. Through its beam correspondence procedure, DUT refines its TX beam toward that direction depending on DUT's beam correspondence capability which shall match OEM declaration:
  - 4a If the DUT's beam correspondence capability `beamCorrespondenceWithoutUL-BeamSweeping` is supported, then DUT autonomously chooses the corresponding TX beam for PUSCH transmission using downlink reference signals to transmit in the direction of the incoming DL signal, which is based on beam correspondence without relying on UL beam sweeping;
  - 4b If the DUT's beam correspondence capability `beamCorrespondenceWithoutUL-BeamSweeping` is not present, then DUT chooses the TX beam for PUSCH transmission which is based on beam correspondence with relying on both DL measurements on downlink reference signals and network-assisted uplink beam sweeping:
    - 4b.1) DUT uses downlink reference signals to select proper RX beam and uses autonomous beam correspondence to select the TX beam.
    - 4b.2) SS configures M=8 SRS resources to DUT, with the field `spatialRelationInfo` omitted and the field usage set as 'beamManagement'. In case DUT supports less than 8 SRS resources, SS configures the number of SRS resources according to the maximum number of SRS resources indicated by UE capability signalling. Additionally, for codebook based PUSCH transmission, SS configures a semi-persistent SRS resource set with the field `usage` as 'codebook'.
    - 4b.3) Based on the TX beam autonomously selected by DUT, DUT chooses TX beams to transmit SRS-resources configured by SS.
    - 4b.4) Based on measurement of the received `beamManagement` SRS, SS chooses the best SRS beam and, if needed, updates the spatial relation information between the semi-persistent `codebook` SRS resources and the SS selected `beamManagement` SRS resource in the activation MAC CE of the semi-persistent SRS resource. The SS indicates in the SRS Resource Indicator (SRI) field in the scheduling grant for PUSCH, if present, the SRS resource within the semi-persistent SRS resource set whose spatial relation is linked to the best detected SRS beam.
    - 4b.5) DUT transmits PUSCH corresponding to the SRS resource indicated by the SRI.
5. Measure UE EIRP value for each grid point according to the EIRP spherical coverage procedure defined in Annex K.1.5, and obtain a cumulative distribution function (CDF) of all EIRP dBm values. Alternatively, UE EIRP measurement for each grid point could be done according to Tx Fast spherical coverage procedure defined in Annex K.1.5.1. After a rotation, allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for UE to find the best beam to use. The measuring duration is one active uplink subframe. EIRP is calculated considering both polarizations, theta and phi.
6. Identify the EIRP dBm value corresponding to %-tile (UE power class dependent) value in the applicable test requirement table in section 6.2.1.2.5.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

#### 6.2.1.2.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with `TRANSFORM_PRECODER_ENABLED` condition in Table 4.6.3-118 PUSCH-Config.

#### 6.2.1.2.5 Test requirement

The defined %-tile EIRP in measurement distribution derived in step 5 shall exceed the values specified in Table 6.2.1.2.5-1 to Table 6.2.1.2.5-4.

**Table 6.2.1.2.5-1: UE spherical coverage for power class 1**

Operating band	Min EIRP at 85%-tile CDF (dBm)
n257	32.0-TT
n258	32.0-TT
n260	30.0-TT
n261	32.0-TT

**Table 6.2.1.2.5-2: UE spherical coverage for power class 2**

Operating band	Min EIRP at 60%-tile CDF (dBm)
n257	18.0-TT
n258	18.0-TT
n260	
n261	18.0-TT

**Table 6.2.1.2.5-3: UE spherical coverage for power class 3 for single band UE or multiband UE declaring MB<sub>s</sub> = 0 in all FR2 bands**

Operating band	Min EIRP at 50%-tile CDF (dBm)
n257	11.5-TT
n258	11.5-TT
n259	5.8-TT
n260	8-TT
n261	11.5-TT

**Table 6.2.1.2.5-3a: UE spherical coverage for power class 3 for multi band UE declaring MB<sub>s</sub>>0 in any FR2 band (Rel-15)**

ID	Supported FR2 bands set	Test requirement (dB) (Note 1)				Maximum sum of MB <sub>s</sub> , ΣMB <sub>s</sub> (dB) (Note 3)	Comments
		n257	n258	n260	n261		
1	n257, n258	11.5-TT-MB <sub>s</sub>	11.5-TT-MB <sub>s</sub>			1.25	Maximum 0.75 dB relaxation allowed for each band
2	n257, n260	11.5-TT-MB <sub>s</sub>		8-TT-MB <sub>s</sub>		0.75	Maximum 0.4 dB relaxation allowed for n260 and 0.75 dB relaxation allowed for all other bands
3	n258, n260		11.5-TT-MB <sub>s</sub>	8-TT-MB <sub>s</sub>		0.75	Maximum 0.4 dB relaxation allowed for n260 and 0.75 dB relaxation allowed for all other bands
4	n258, n261		11.5-TT-MB <sub>s</sub>		11.5-TT-MB <sub>s</sub>	1.25	Maximum 0.75 dB relaxation allowed for each band
5	n260, n261			8-TT-MB <sub>s</sub>	11.5-TT-MB <sub>s</sub>	0.75	No relaxation allowed for n260 and 0.75 dB relaxation allowed for all other bands
6	n257, n258, n260	11.5-TT-MB <sub>s</sub>	11.5-TT-MB <sub>s</sub>	8-TT-MB <sub>s</sub>		1.75	Maximum 0.4 dB relaxation allowed for n260 and 0.75 dB relaxation allowed for all other bands
7	n257, n258, n261	11.5-TT-MB <sub>s</sub>	11.5-TT-MB <sub>s</sub>		11.5-TT-MB <sub>s</sub>	1.75	Maximum 0.75 dB relaxation allowed for each band

8	n257, n260, n261	11.5-TT-MB <sub>s</sub>		8-TT-MB <sub>s</sub>	11.5-TT-MB <sub>s</sub>	1.25	Maximum 0.4 dB relaxation allowed for n260 and 0.75 dB relaxation allowed for all other bands
9	n258, n260, n261		11.5-TT-MB <sub>s</sub>	8-TT-MB <sub>s</sub>	11.5-TT-MB <sub>s</sub>	1.25	Maximum 0.4 dB relaxation allowed for n260 and 0.75 dB relaxation allowed for all other bands
10	n257, n258, n260, n261	11.5-TT-MB <sub>s</sub>	11.5-TT-MB <sub>s</sub>	8-TT-MB <sub>s</sub>	11.5-TT-MB <sub>s</sub>	1.75	Maximum 0.4 dB relaxation allowed for n260 and 0.75 dB relaxation allowed for all other bands

Note 1: MB<sub>s</sub> is the Multiband Relaxation factor declared by the UE for the tested band in table A.4.3.9-3 of TS38.508-2 [11]. This declaration shall fulfil the requirements in Table 6.2.1.1.3.3-4.

Note 2: All UE supported bands needs to be tested to ensure the multiband relaxation declaration is compliant

Note 3: Max allowed sum of MB<sub>s</sub> over all supported FR2 bands as defined in clause 6.2.1.1.3.3.

Note 4: For a Rel-15 UE supporting FR2 bands set not defined in Table 6.2.1.1.3.3-4, Table 6.2.1.2.5-3c applies.

**Table 6.2.1.2.5-3b: Test Tolerance (UE spherical coverage for Power class 3)**

Test Metric	FR2a	FR2b
Max device size ≤ 30 cm	2.58 dB	2.58 dB

**Table 6.2.1.2.5-3c: UE spherical coverage for power class 3 (Rel-16 and forward)**

ID	FR2 bands/set	Test requirement (dB) (Note 1)					Comments
		n257	n258	n259	n260	n261	
1	n257	11.5-TT-ΔMB <sub>s,n</sub>					
2	n258		11.5-TT-ΔMB <sub>s,n</sub>				
3	n259			5.8-TT-ΔMB <sub>s,n</sub>			
4	n260				8-TT-ΔMB <sub>s,n</sub>		
5	n261					11.5-TT-ΔMB <sub>s,n</sub>	
6	n257, n261	11.5-TT-ΔMB <sub>s,n</sub>				11.5-TT-ΔMB <sub>s,n</sub>	ΔMB <sub>s,n</sub> relaxation is 0 dB
7	n260, n261				8-TT-ΔMB <sub>s,n</sub>	11.5-TT-ΔMB <sub>s,n</sub>	ΔMB <sub>s,n</sub> relaxation is 0 dB for n260

Note 1: ΔMB<sub>s,n</sub> is the Multiband Relaxation factor for the tested band. This shall fulfil the requirements in Table 6.2.1.1.3.3-5.

**Table 6.2.1.2.5-4: UE spherical coverage for power class 4**

Operating band	Min EIRP at 20%-tile CDF (dBm)
n257	25
n258	25
n260	19
n261	25

**6.2.1.2\_1 UE maximum output power - Spherical coverage (Rel16 and forward)**

Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:

- Same as in 6.2.1.2

**6.2.1.2\_1.1 Test purpose**

Same as 6.2.1.2.1.

6.2.1.2.2 Test applicability

This test case applies to all types of NR UE release 16 and forward supporting either SSB-based or CSI-RS based enhanced beam correspondence without UL beam sweeping.

6.2.1.2\_1.3 Minimum conformance requirements

Same as 6.2.1.1\_1.3

6.2.1.2\_1.4 Test description

6.2.1.2\_1.4.1 Initial conditions

Same as 6.2.1.2.4.1

6.2.1.2.4.2 Test procedure

The following cases are tested depending on UE capability:

1. Test procedure if *beamCorrespondenceWithoutUL-BeamSweeping* is NOT supported and *beamCorrespondenceSSB-based-r16* is supported:
  - 1.1 Same as 6.2.1.2.4.2 with the exception that measurements shall be carried out using only side conditions defined in Table 6.6.1.3.3.1.1-1
  - 1.2 End test procedure
2. Test procedure if *beamCorrespondenceWithoutUL-BeamSweeping* is NOT supported, and *beamCorrespondenceCSI-RS-based-r16* is supported
  - 2.1 Same as 6.2.1.2.4.2 with the exception that measurements shall be carried out using only side conditions defined in Table 6.6.2.3.3-1
  - 2.2 End test procedure .
3. Test procedure if *beamCorrespondenceWithoutUL-BeamSweeping* is supported and *beamCorrespondenceSSB-based-r16* is supported:
  - 3.1 Same as 6.2.1.2.4.2 with the exception that measurements shall be carried out using only side conditions defined in Table 6.6.1.3.3.1.1-1
  - 3.2 End test procedure
4. Test procedure if *beamCorrespondenceWithoutUL-BeamSweeping* is supported and *beamCorrespondenceCSI-RS-based-r16* is supported:
  - 4.1 Same as 6.2.1.2.4.2 with the exception that step 7 is skipped and measurements shall be carried out using only side conditions defined in Table 6.6.2.3.3-1
  - 4.2 End test procedure

6.2.1.2\_1.4.3 Message contents

Same as 6.2.1.1\_4.3 and 6.6.1.4.3.

6.2.1.2.5 Test requirement

Same as 6.2.1.2\_1,5 except Table 6.2.1.2\_1.5-1 below.

**Table 6.2.1.2\_1.5-1: UE spherical coverage for power class 3 (Rel-16 and forward)**

ID	FR2 bands/set	Test requirement (dB) (Note 1)					Comments
		n257	n258	n259	n260	n261	

1	n257	11.5-TT- $\Delta MB_{s,n}$					
2	n258		11.5-TT- $\Delta MB_{s,n}$				
3	n259			5.8-TT- $\Delta MB_{s,n}$			
4	n260				8-TT- $\Delta MB_{s,n}$		
5	n261					11.5-TT- $\Delta MB_{s,n}$	
6	n257, n261	11.5-TT- $\Delta MB_{s,n}$				11.5-TT- $\Delta MB_{s,n}$	$\Delta MB_{s,n}$ relaxation is 0 dB
7	n260, n261				8-TT- $\Delta MB_{s,n}$	11.5-TT- $\Delta MB_{s,n}$	$\Delta MB_{s,n}$ relaxation is 0 dB for n260

Note 1:  $\Delta MB_{s,n}$  is the Multiband Relaxation factor for the tested band. This shall fulfil the requirements in Table 6.2.1.1.3.3-5.

## 6.2.2 UE maximum output power reduction

Editor's note: The following aspects are either missing or not yet determined:

- Measurement Uncertainties and Test Tolerances are FFS for PC1, PC2 and PC4.
- Measurement grid for PC2/4 in Annex M.4 is FFS.
- Once test case 6.2.2\_1 is available for certification, the test applicability needs an update to exclude Rel15 UE supporting modifiedMPR bit 0 and Rel16 and later UE.

### 6.2.2.0 General

The requirements in section 6.2.2 only apply when both UL and DL of a UE are configured for single CC operation, and they are of the same bandwidth. A UE may reduce its maximum output power due to modulation orders, transmit bandwidth configurations, waveform types and narrow allocations. This Maximum Power Reduction (MPR) is defined in subclauses below. The allowed MPR for SRS, PUCCH formats 0, 1, 3 and 4, and PRACH shall be as specified for QPSK modulated DFT-s-OFDM of equivalent RB allocation. The allowed MPR for PUCCH format 2 shall be as specified for QPSK modulated CP-OFDM of equivalent RB allocation. When the maximum output power of a UE is modified by MPR, the power limits specified in subclause 6.2.4 apply.

For a UE that is configured for single CC operation with different channel bandwidths in UL and DL, the requirements in section 6.2A.2 apply.

For all power classes, the waveform defined by BW = 100 MHz, SCS = 120 kHz, DFT-S-OFDM QPSK, 20RB23 is the reference waveform with 0 dB MPR and is used for the power class definition.

#### 6.2.2.1 Test purpose

The number of RB identified in 6.2.2.3 is based on meeting the requirements for the maximum power reduction (MPR) due to Cubic Metric (CM).

#### 6.2.2.2 Test applicability

The requirements of this test apply to all types of NR UE release 15 and forward.

#### 6.2.2.3 Minimum conformance requirements

##### 6.2.2.3.1 UE maximum output power reduction for power class 1

For power class 1, MPR for contiguous allocations is defined as:

$$MPR = \max(MPR_{WT}, MPR_{narrow})$$

Where,

$MPR_{narrow} = 14.4$  dB, when  $BW_{alloc,RB} \leq 1.44$  MHz,  $MPR_{narrow} = 10$  dB, when  $1.44$  MHz <  $BW_{alloc,RB} \leq 10.8$  MHz, where  $BW_{alloc,RB}$  is the bandwidth of the RB allocation size.

$MPR_{WT}$  is the maximum power reduction due to modulation orders, transmission bandwidth configurations listed in Table 5.3.2-1, and waveform types.  $MPR_{WT}$  is defined in Tables 6.2.2.3.1-1 and 6.2.2.3.1-2.

**Table 6.2.2.3.1-1:  $MPR_{WT}$  for power class 1,  $BW_{channel} \leq 200$  MHz**

Modulation		$MPR_{WT}$ (dB), $BW_{channel} \leq 200$ MHz		
		Outer RB allocations	Inner RB allocations	
			Region 1	Region 2
DFT-s-OFDM	Pi/2 BPSK	$\leq 5.5$	0.0	$\leq 3.0$
	QPSK	$\leq 6.5$	0.0	$\leq 3.0$
	16 QAM	$\leq 6.5$	$\leq 4.0$	$\leq 4.0$
	64 QAM	$\leq 6.5$	$\leq 5.0$	$\leq 5.0$
CP-OFDM	QPSK	$\leq 7.0$	$\leq 4.5$	$\leq 4.5$
	16 QAM	$\leq 7.0$	$\leq 5.5$	$\leq 5.5$
	64 QAM	$\leq 7.5$	$\leq 7.5$	$\leq 7.5$

**Table 6.2.2.3.1-2:  $MPR_{WT}$  for power class 1,  $BW_{channel} = 400$  MHz**

Modulation		$MPR_{WT}$ (dB), $BW_{channel} = 400$ MHz		
		Outer RB allocations	Inner RB allocations	
			Region 1	Region 2
DFT-s-OFDM	Pi/2 BPSK	$\leq 5.5$	0.0	$\leq 3.0$
	QPSK	$\leq 6.5$	0.0	$\leq 3.5$
	16 QAM	$\leq 6.5$	$\leq 4.5$	$\leq 4.5$
	64 QAM	$\leq 6.5$	$\leq 6.5$	$\leq 6.5$
CP-OFDM	QPSK	$\leq 7.0$	$\leq 5.0$	$\leq 5.0$
	16 QAM	$\leq 7.0$	$\leq 6.5$	$\leq 6.5$
	64 QAM	$\leq 9.0$	$\leq 9.0$	$\leq 9.0$

Where the following parameters are defined to specify valid RB allocation ranges for the RB allocations regions in Tables 6.2.2.3.1-1 and 6.2.2.3.1-2:

$N_{RB}$  is the maximum number of RBs for a given Channel bandwidth and sub-carrier spacing defined in Table 5.3.2-1.

$$RB_{end} = RB_{start} + L_{CRB} - 1$$

$$RB_{start,Low} = \text{Max}(1, \text{Floor}(L_{CRB}/2))$$

$$RB_{start,High} = N_{RB} - RB_{start,Low} - L_{CRB}$$

An RB allocation is an Outer RB allocation if

$$RB_{start} < RB_{start,Low} \text{ OR } RB_{start} > RB_{start,High} \text{ OR } L_{CRB} > \text{Ceil}(N_{RB}/2)$$

An RB allocation belonging to Table 6.2.2.3.1-1 is a Region 1 inner RB allocation if

$$RB_{start} \geq \text{Ceil}(1/3 N_{RB}) \text{ AND } RB_{end} < \text{Ceil}(2/3 N_{RB})$$

An RB allocation belonging to Table 6.2.2.3.1-2 is a Region 1 inner RB allocation if

$$RB_{start} \geq \text{Ceil}(1/4 N_{RB}) \text{ AND } RB_{end} < \text{Ceil}(3/4 N_{RB}) \text{ AND } L_{CRB} \leq \text{Ceil}(1/4 N_{RB})$$

An RB allocation is a Region 2 inner allocation if it is NOT an Outer allocation AND NOT a Region 1 inner allocation.

For the UE maximum output power modified by MPR, the power limits specified in subclause 6.2.4 apply.

The normative reference for this requirement is TS 38.101-2 [3] clause 6.2.2.1.

### 6.2.2.3.2 UE maximum output power reduction for power class 2

For power class 2, MPR specified in subclause 6.2.2.3.3 applies.

**Table 6.2.2.3.2-1: Void**

The normative reference for this requirement is TS 38.101-2 [3] clause 6.2.2.2.

### 6.2.2.3.3 UE maximum output power reduction for power class 3

For power class 3, MPR for contiguous allocations is defined as:

$$\text{MPR} = \max(\text{MPR}_{\text{WT}}, \text{MPR}_{\text{narrow}})$$

Where,

$\text{MPR}_{\text{narrow}} = 2.5 \text{ dB}$ ,  $\text{BW}_{\text{alloc, RB}} \leq 1.44 \text{ MHz}$ , and  $0 \leq \text{RB}_{\text{start}} < \text{Ceil}(1/3 N_{\text{RB}})$  or  $\text{Ceil}((2/3 N_{\text{RB}}) - \text{L}_{\text{CRB}}) \leq \text{RB}_{\text{start}} \leq N_{\text{RB}} - \text{L}_{\text{CRB}}$ , where  $\text{BW}_{\text{alloc, RB}}$  is the bandwidth of the RB allocation size.

$\text{MPR}_{\text{WT}}$  is the maximum power reduction due to modulation orders, transmission bandwidth configurations listed in Table 5.3.2-1, and waveform types.  $\text{MPR}_{\text{WT}}$  is defined in Table 6.2.2.3.3-1 and Table 6.2.2.3.3-2.

**Table 6.2.2.3.3-1:  $\text{MPR}_{\text{WT}}$  for power class 3,  $\text{BW}_{\text{channel}} \leq 200 \text{ MHz}$** 

Modulation		$\text{MPR}_{\text{WT}}, \text{BW}_{\text{channel}} \leq 200 \text{ MHz}$	
		Inner RB allocations, Region 1	Edge RB allocations
DFT-s-OFDM	Pi/2 BPSK	0.0	$\leq 2.0$
	QPSK	0.0	$\leq 2.0$
	16 QAM	$\leq 3.0$	$\leq 3.5$
	64 QAM	$\leq 5.0$	$\leq 5.5$
CP-OFDM	QPSK	$\leq 3.5$	$\leq 4.0$
	16 QAM	$\leq 5.0$	$\leq 5.0$
	64 QAM	$\leq 7.5$	$\leq 7.5$

**Table 6.2.2.3.3-2:  $\text{MPR}_{\text{WT}}$  for power class 3,  $\text{BW}_{\text{channel}} = 400 \text{ MHz}$** 

Modulation		$\text{MPR}_{\text{WT}}, \text{BW}_{\text{channel}} = 400 \text{ MHz}$	
		Inner RB allocations, Region 1	Edge RB allocations
DFT-s-OFDM	Pi/2 BPSK	0.0	$\leq 3.0$
	QPSK	0.0	$\leq 3.0$
	16 QAM	$\leq 4.5$	$\leq 4.5$
	64 QAM	$\leq 6.5$	$\leq 6.5$
CP-OFDM	QPSK	$\leq 5.0$	$\leq 5.0$
	16 QAM	$\leq 6.5$	$\leq 6.5$
	64 QAM	$\leq 9.0$	$\leq 9.0$

Where the following parameters are defined to specify valid RB allocation ranges for RB allocations in Tables 6.2.2.3.3-1 and 6.2.2.3.3-2:

$N_{\text{RB}}$  is the maximum number of RBs for a given Channel bandwidth and sub-carrier spacing defined in Table 5.3.2-1.

$$\text{RB}_{\text{end}} = \text{RB}_{\text{start}} + \text{L}_{\text{CRB}} - 1$$

An RB allocation belonging to Table 6.2.2.3.3-1 is a Region 1 inner RB allocation if

$$\text{RB}_{\text{start}} \geq \text{Ceil}(1/3 N_{\text{RB}}) \text{ AND } \text{RB}_{\text{end}} < \text{Ceil}(2/3 N_{\text{RB}})$$

An RB allocation belonging to Table 6.2.2.3.3-2 is a Region 1 inner RB allocation if

$$\text{RB}_{\text{start}} \geq \text{Ceil}(1/4 N_{\text{RB}}) \text{ AND } \text{RB}_{\text{end}} < \text{Ceil}(3/4 N_{\text{RB}}) \text{ AND } \text{L}_{\text{CRB}} \leq \text{Ceil}(1/4 N_{\text{RB}})$$

An RB allocation is an Edge allocation if it is NOT a Region 1 inner allocation.

The normative reference for this requirement is TS 38.101-2 [3] clause 6.2.2.3.

6.2.2.3.4 UE maximum output power reduction for power class 4

For power class 4, MPR specified in sub-clause 6.2.2.3.3 applies.

**Table 6.2.2.3.4-1: Void**

The normative reference for this requirement is TS 38.101-2 [3] clause 6.2.2.4.

6.2.2.4 Test description

6.2.2.4.1 Initial conditions

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, and channel bandwidths based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each channel bandwidth and subcarrier spacing, are shown in Table 6.2.2.4.1-1 to Table 6.2.2.4.1-9. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.2.2.4.1-1: Test Configuration Table (Power Class 1, MPR<sub>narrow</sub>)**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal, TL, TH		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1				Low range, High range		
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1				Lowest and Highest		
Test SCS as specified in Table 5.3.5-1				Lowest, Highest		
Test Parameters						
Test ID	Freq	ChBw	SCS	Downlink Configuration	Uplink Configuration	
		Default	Default	-	Modulation	RB allocation (NOTE 1)
1	Low				CP-OFDM 64 QAM	Outer_1RB_Left
2	High				CP-OFDM 64 QAM	Outer_1RB_Right
3	Low				CP-OFDM 64 QAM	2@0
4	High				CP-OFDM 64 QAM	2@N <sub>RB</sub> -2
5	Low				CP-OFDM 64 QAM	7@0
6	High				CP-OFDM 64 QAM	7@N <sub>RB</sub> -7
NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-2.						

**Table 6.2.2.4.1-2: Test Configuration Table (Power Class 1, MPR<sub>WT</sub>, BW<sub>channel</sub> ≤ 200 MHz)**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal, TL, TH		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1				Low range, Mid range, High range		
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1				Lowest and Highest supported channel bandwidth that ≤ 200 MHz		
Test SCS as specified in Table 5.3.5-1				Lowest, Highest		
Test Parameters						
Test ID	Freq	ChBw	SCS	Downlink Configuration	Uplink Configuration	
		Default	Default	-	Modulation	RB allocation (NOTE 1)



1	Low				DFT-s-OFDM PI/2 BPSK	8@0
2	High				DFT-s-OFDM PI/2 BPSK	8@N <sub>RB</sub> -8
3	Mid				DFT-s-OFDM PI/2 BPSK	Outer_Full
4	Mid				DFT-s-OFDM QPSK	Inner_Full_Region2
5	Low				DFT-s-OFDM QPSK	8@0
6	High				DFT-s-OFDM QPSK	8@N <sub>RB</sub> -8
7	Mid				DFT-s-OFDM QPSK	Outer_Full
8	Mid				DFT-s-OFDM 16 QAM	Inner_Full_Region2
9	Low				DFT-s-OFDM 16 QAM	8@0
10	High				DFT-s-OFDM 16 QAM	8@N <sub>RB</sub> -8
11	Mid				DFT-s-OFDM 16 QAM	Outer_Full
12	Low				DFT-s-OFDM 64 QAM	8@0
13	High				DFT-s-OFDM 64 QAM	8@N <sub>RB</sub> -8
14	Mid				DFT-s-OFDM 64 QAM	Outer_Full
15	Mid				DFT-s-OFDM 64 QAM	Inner_Full_Region2
16	Mid				CP-OFDM QPSK	Inner_Full_Region2
17	Low				CP-OFDM QPSK	8@0
18	High				CP-OFDM QPSK	8@N <sub>RB</sub> -8
19	Mid				CP-OFDM QPSK	Outer_Full
20	Low				CP-OFDM 16 QAM	8@0
21	High				CP-OFDM 16 QAM	8@N <sub>RB</sub> -8
22	Mid				CP-OFDM 16 QAM	Outer_Full
23	Mid				CP-OFDM 16 QAM	Inner_Full_Region2
24	Low				CP-OFDM 64 QAM	8@0
25	High				CP-OFDM 64 QAM	8@N <sub>RB</sub> -8
26	Mid				CP-OFDM 64 QAM	Outer_Full

NOTE 1: The specific configuration of each RF allocation is defined in clause 6.1-2.

**Table 6.2.2.4.1-3: Test Configuration Table (Power Class 1, MPR<sub>WT</sub>, BW<sub>channel</sub> = 400 MHz)**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1					Normal, TL, TH	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1					Low range, Mid range, High range	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1					400 MHz	
Test SCS as specified in Table 5.3.5-1					120kHz	
Test Parameters						
Test ID	Freq	ChBw	SCS	Downlink Configuration	Uplink Configuration	
					Modulation	RB allocation (NOTE 1)
1	Low	Default	Default	-	DFT-s-OFDM PI/2 BPSK	8@0
2	High				DFT-s-OFDM PI/2 BPSK	8@N <sub>RB</sub> -8
3	Mid				DFT-s-OFDM PI/2 BPSK	Outer_Full
4	Mid				DFT-s-OFDM PI/2	Inner_Full_Region2

					BPSK	
5	Mid				DFT-s-OFDM QPSK	Inner_Full_Region2
6	Low				DFT-s-OFDM QPSK	8@0
7	High				DFT-s-OFDM QPSK	8@N <sub>RB</sub> -8
8	Mid				DFT-s-OFDM QPSK	Outer_Full
9	Mid				DFT-s-OFDM 16 QAM	Inner_Full_Region2
10	Low				DFT-s-OFDM 16 QAM	8@0
11	High				DFT-s-OFDM 16 QAM	8@N <sub>RB</sub> -8
12	Mid				DFT-s-OFDM 16 QAM	Outer_Full
13	Low				DFT-s-OFDM 64 QAM	8@0
14	High				DFT-s-OFDM 64 QAM	8@N <sub>RB</sub> -8
15	Mid				DFT-s-OFDM 64 QAM	Outer_Full
16	Mid				CP-OFDM QPSK	Inner_Full_Region2
17	Low				CP-OFDM QPSK	8@0
18	High				CP-OFDM QPSK	8@N <sub>RB</sub> -8
19	Mid				CP-OFDM QPSK	Outer_Full
20	Low				CP-OFDM 16 QAM	8@0
21	High				CP-OFDM 16 QAM	8@N <sub>RB</sub> -8
22	Mid				CP-OFDM 16 QAM	Outer_Full
23	Mid				CP-OFDM 16 QAM	Inner_Full_Region2
24	Low				CP-OFDM 64 QAM	8@0
25	High				CP-OFDM 64 QAM	8@N <sub>RB</sub> -8
26	Mid				CP-OFDM 64 QAM	Outer_Full
NOTE 1: The specific configuration of each RF allocation is defined in clause 6.1-2.						

Table 6.2.2.4.1-4: Void

Table 6.2.2.4.1-5: Void

Table 6.2.2.4.1-6: Void

Table 6.2.2.4.1-7: Test Configuration Table (Power Class 2, 3 and 4, MPR<sub>narrow</sub>, BW<sub>channel</sub> ≤ 200 MHz)

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal, TL, TH		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1				Low range, High range		
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1				Lowest and Highest supported channel bandwidth that ≤ 200 MHz		
Test SCS as specified in Table 5.3.5-1				Lowest, Highest		
Test Parameters						
Test ID	Freq	ChBw	SCS	Downlink Configuration	Uplink Configuration	
		Default	Default	-	Modulation	RB allocation (NOTE 1)
1	Low				DFT-s-OFDM PI/2 BPSK	Outer_1RB_Left
2	High				DFT-s-OFDM PI/2 BPSK	Outer_1RB_Right
3	Low				DFT-s-OFDM QPSK	Outer_1RB_Left
4	High				DFT-s-OFDM QPSK	Outer_1RB_Right
NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-1.						

**Table 6.2.2.4.1-8: Test Configuration Table (Power Class 2, 3 and 4,  $MPR_{WT}$ ,  $BW_{channel} \leq 200$  MHz)**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal, TL, TH		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1				Low range, Mid range, High range		
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1				Lowest and Highest supported channel bandwidth that $\leq 200$ MHz		
Test SCS as specified in Table 5.3.5-1				Lowest, Highest		
Test Parameters						
Test ID	Freq	ChBw	SCS	Downlink Configuration	Uplink Configuration	
		Default	Default	-	Modulation	RB allocation (NOTE 1)
1	Mid				DFT-s-OFDM PI/2 BPSK	Outer_Full
2	Mid				DFT-s-OFDM QPSK	Outer_Full
3	Mid				DFT-s-OFDM 16 QAM	Inner_Full
4	Low				DFT-s-OFDM 16 QAM	Outer_1RB_Left
5	High				DFT-s-OFDM 16 QAM	Outer_1RB_Right
6	Mid				DFT-s-OFDM 16 QAM	Outer_Full
7	Mid				DFT-s-OFDM 64 QAM	Inner_Full
8	Low				DFT-s-OFDM 64 QAM	Outer_1RB_Left
9	High				DFT-s-OFDM 64 QAM	Outer_1RB_Right
10	Mid				DFT-s-OFDM 64 QAM	Outer_Full
11	Mid				CP-OFDM QPSK	Inner_Full
12	Low				CP-OFDM QPSK	Outer_1RB_Left
13	High				CP-OFDM QPSK	Outer_1RB_Right
14	Mid				CP-OFDM QPSK	Outer_Full
15	Low				CP-OFDM 16 QAM	Outer_1RB_Left
16	High				CP-OFDM 16 QAM	Outer_1RB_Right
17	Mid				CP-OFDM 16 QAM	Outer_Full
18	Low				CP-OFDM 64 QAM	Outer_1RB_Left
19	High				CP-OFDM 64 QAM	Outer_1RB_Right
20	Mid	CP-OFDM 64 QAM	Outer_Full			
NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-1.						

**Table 6.2.2.4.1-8a: Test Configuration Table (Power Class 2, 3, 4,  $MPR_{narrow}$ ,  $BW_{channel} = 400$  MHz)**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal, TL, TH		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1				Low range, High range		
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1				400 MHz		
Test SCS as specified in Table 5.3.5-1				120 kHz		
Test Parameters						
Test ID	Freq	ChBw	SCS	Downlink Configuration	Uplink Configuration	
		Default	Default	N/A for Maximum Power Reduction ( $MPR$ ) test case	Modulation	RB allocation (NOTE 1)
1	Low				DFT-s-OFDM PI/2 BPSK	Inner_1RB_Left
2	High				DFT-s-OFDM PI/2 BPSK	Inner_1RB_Right
3	Low				DFT-s-OFDM QPSK	Inner_1RB_Left
4	High				DFT-s-OFDM QPSK	Inner_1RB_Right
NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-1.						

**Table 6.2.2.4.1-9: Test Configuration Table (Power Class 2, 3 and 4,  $MPR_{WT}$ ,  $BW_{channel} = 400$  MHz)**

Default Conditions	
Test Environment as specified in TS 38.508-1 [10] subclause 4.1	Normal, TL, TH
Test Frequencies as specified in TS 38.508-1 [10]	Low range, Mid range, High range

subclause 4.3.1						
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1					400 MHz	
Test SCS as specified in Table 5.3.5-1					120kHz	
Test Parameters						
Test ID	Freq	ChBw	SCS	Downlink Configuration	Uplink Configuration	
					Modulation	RB allocation (NOTE 1)
1	Low	Default	Default	-	DFT-s-OFDM PI/2 BPSK	Outer_1RB_Left
2	High				DFT-s-OFDM PI/2 BPSK	Outer_1RB_Right
3	Mid				DFT-s-OFDM PI/2 BPSK	Outer_Full
4	Low				DFT-s-OFDM QPSK	Outer_1RB_Left
5	High				DFT-s-OFDM QPSK	Outer_1RB_Right
6	Mid				DFT-s-OFDM QPSK	Outer_Full
7	Low				DFT-s-OFDM 16 QAM	Outer_1RB_Left
8	High				DFT-s-OFDM 16 QAM	Outer_1RB_Right
9	Mid				DFT-s-OFDM 16 QAM	Outer_Full
10	Low				DFT-s-OFDM 64 QAM	Outer_1RB_Left
11	High				DFT-s-OFDM 64 QAM	Outer_1RB_Right
12	Mid				DFT-s-OFDM 64 QAM	Outer_Full
13	Low				CP-OFDM QPSK	Outer_1RB_Left
14	High				CP-OFDM QPSK	Outer_1RB_Right
15	Mid				CP-OFDM QPSK	Outer_Full
16	Low				CP-OFDM 16 QAM	Outer_1RB_Left
17	High				CP-OFDM 16 QAM	Outer_1RB_Right
18	Mid				CP-OFDM 16 QAM	Outer_Full
19	Low				CP-OFDM 64 QAM	Outer_1RB_Left
20	High				CP-OFDM 64 QAM	Outer_1RB_Right
21	Mid				CP-OFDM 64 QAM	Outer_Full
NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-1.						

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement channels are set according to Table 6.2.2.4.1-1 to Table 6.2.2.4.1-9.
5. Propagation conditions are set according to Annex B.0
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity NR, Connected without release On, Test Mode On and Test Loop Function On according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.2.2.4.3.

6.2.2.4.2 Test procedure

1. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.2.2.4.1-1 to Table 6.2.2.4.1-9. Since the UL has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC.
2. Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
3. Send continuously uplink power control "up" commands in every uplink scheduling information to the UE; allow at least 200ms for the UE to reach P<sub>UMAX</sub> level. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
4. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
5. Measure UE EIRP in the Tx beam peak direction in the channel bandwidth of the radio access mode according to the test configuration, which shall meet the requirements described in 6.2.2.5. EIRP test procedure is defined in

Annex K.1.3. The measuring duration is one active uplink subframe. EIRP is calculated considering both polarizations, theta and phi.

6. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

NOTE 2: When switching to DFT-s-OFDM waveform, as specified in Table 6.2.2.4.1-1 to Table 6.2.2.4.1-9, send an NR RRCReconfiguration message according to TS 38.508-1 [10] clause 4.6.3 Table 4.6.3-118 PUSCH-Config with TRANSFORM\_PRECODER\_ENABLED condition.

#### 6.2.2.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6.

#### 6.2.2.5 Test requirement

The maximum output power, derived in step 5 shall be within the range prescribed by the nominal maximum output power and tolerance in following tables.

Table 6.2.2.5-1: UE Power Class test requirements for Power Class 1 (for Bands n257, n258, n261)

Test Configuration Table	Test ID	$P_{\text{Powerclass}}$	$\text{MPR}_{f,c}$	$T(\text{MPR}_{f,c})$	Lower limit (dBm)	Upper limit (dBm)
Table 6.2.2.4.1-1	1	40	14.4	7	18.6-TT	55
	2	40	14.4	7	18.6-TT	55
	3	40	10	5	25-TT	55
	4	40	10	5	25-TT	55
	5	40	10	5	25-TT	55
	6	40	10	5	25-TT	55
Table 6.2.2.4.1-2	1	40	5.5	5	29.5-TT	55
	2	40	5.5	5	29.5-TT	55
	3	40	5.5	5	29.5-TT	55
	4	40	3	2	35-TT	55
	5	40	6.5	5	28.5-TT	55
	6	40	6.5	5	28.5-TT	55
	7	40	6.5	5	28.5-TT	55
	8	40	4	3	33-TT	55
	9	40	6.5	5	28.5-TT	55
	10	40	6.5	5	28.5-TT	55
	11	40	6.5	5	28.5-TT	55
	12	40	6.5	5	28.5-TT	55
	13	40	6.5	5	28.5-TT	55
	14	40	6.5	5	28.5-TT	55
	15	40	5	4	31-TT	55
	16	40	4.5	4	31.5-TT	55
	17	40	7	5	28-TT	55
	18	40	7	5	28-TT	55
	19	40	7	5	28-TT	55
	20	40	7	5	28-TT	55
	21	40	7	5	28-TT	55
	22	40	7	5	28-TT	55
	23	40	5.5	5	29.5-TT	55
	24	40	7.5	5	27.5-TT	55
	256	40	7.5	5	27.5-TT	55
	26	40	7.5	5	27.5-TT	55
Table 6.2.2.4.1-3	1	40	5.5	5	29.5-TT	55
	2	40	5.5	5	29.5-TT	55
	3	40	5.5	5	29.5-TT	55
	4	40	3	2	35-TT	55
	5	40	3.5	3	33.5-TT	55
	6	40	6.5	5	28.5-TT	55
	7	40	6.5	5	28.5-TT	55
	8	40	6.5	5	28.5-TT	55
	9	40	4.5	4	31.5-TT	55
	10	40	6.5	5	28.5-TT	55
	11	40	6.5	5	28.5-TT	55
	12	40	6.5	5	28.5-TT	55

13	40	6.5	5	28.5-TT	55
14	40	6.5	5	28.5-TT	55
15	40	6.5	5	28.5-TT	55
16	40	5	4	31-TT	55
17	40	7	5	28-TT	55
18	40	7	5	28-TT	55
19	40	7	5	28-TT	55
20	40	7	5	28-TT	55
21	40	7	5	28-TT	55
22	40	7	5	28-TT	55
23	40	6.5	5	28.5-TT	55
24	40	9	5	26-TT	55
25	40	9	5	26-TT	55
26	40	9	5	26-TT	55

**Table 6.2.2.5-1a: UE Power Class test requirements for Power Class 1 (for Bands n260)**

Test Configuration Table	Test ID	P <sub>Powerclass</sub>	MPR <sub>f,c</sub>	T(MPR <sub>f,c</sub> )	Lower limit (dBm)	Upper limit (dBm)
Table 6.2.2.4.1-1	1	38	14.4	7	16.6-TT	55
	2	38	14.4	7	16.6-TT	55
	3	38	10	5	23-TT	55
	4	38	10	5	23-TT	55
	5	38	10	5	23-TT	55
	6	38	10	5	23-TT	55
Table 6.2.2.4.1-2	1	38	5.5	5	27.5-TT	55
	2	38	5.5	5	27.5-TT	55
	3	38	5.5	5	27.5-TT	55
	4	38	3	2	33-TT	55
	5	38	6.5	5	26.5-TT	55
	6	38	6.5	5	26.5-TT	55
	7	38	6.5	5	26.5-TT	55
	8	38	4	3	31-TT	55
	9	38	6.5	5	26.5-TT	55
	10	38	6.5	5	26.5-TT	55
	11	38	6.5	5	26.5-TT	55
	12	38	6.5	5	26.5-TT	55
	13	38	6.5	5	26.5-TT	55
	14	38	6.5	5	26.5-TT	55
	15	38	5	4	29-TT	55
	16	38	4.5	4	29.5-TT	55
	17	38	7	5	26-TT	55
	18	38	7	5	26-TT	55
	19	38	7	5	26-TT	55
	20	38	7	5	26-TT	55
	21	38	7	5	26-TT	55
	22	38	7	5	26-TT	55

Table 6.2.2.4.1-3	23	38	5.5	5	27.5-TT	55
	24	38	7.5	5	25.5-TT	55
	25	38	7.5	5	25.5-TT	55
	26	38	7.5	5	25.5-TT	55
	1	38	5.5	5	27.5-TT	55
	2	38	5.5	5	27.5-TT	55
	3	38	5.5	5	27.5-TT	55
	4	38	3	2	33-TT	55
	5	38	3.5	3	31.5-TT	55
	6	38	6.5	5	26.5-TT	55
	7	38	6.5	5	26.5-TT	55
	8	38	6.5	5	26.5-TT	55
	9	38	4.5	4	29.5-TT	55
	10	38	6.5	5	26.5-TT	55
	11	38	6.5	5	26.5-TT	55
	12	38	6.5	5	26.5-TT	55
	13	38	6.5	5	26.5-TT	55
	14	38	6.5	5	26.5-TT	55
	15	38	6.5	5	26.5-TT	55
	16	38	5	4	29-TT	55
	17	38	7	5	26-TT	55
	18	38	7	5	26-TT	55
	19	38	7	5	26-TT	55
	20	38	7	5	26-TT	55
	21	38	7	5	26-TT	55
	22	38	7	5	26-TT	55
23	38	6.5	5	26.5-TT	55	
24	38	9	5	24-TT	55	
25	38	9	5	24-TT	55	
26	38	9	5	24-TT	55	

**Table 6.2.2.5-2: UE Power Class test requirements for Power Class 2**

Test Configuration Table	Test ID	$P_{Powerclass}$	$MPR_{f,c}$	$T(MPR_{f,c})$	Lower limit (dBm)	Upper limit (dBm)
Table 6.2.2.4.1-7	1	29	2.5	2	24.5-TT	43
	2	29	2.5	2	24.5-TT	43
	3	29	2.5	2	24.5-TT	43
	4	29	2.5	2	24.5-TT	43
Table 6.2.2.4.1-8	1	29	2	1.5	25.5-TT	43
	2	29	2	1.5	25.5-TT	43
	3	29	3	2	24-TT	43
	4	29	3.5	3	22.5-TT	43
	5	29	3.5	3	22.5-TT	43
	6	29	3.5	3	22.5-TT	43
	7	29	5	4	20-TT	43
	8	29	5.5	5	18.5-TT	43



	9	29	5.5	5	18.5-TT	43
	10	29	5.5	5	18.5-TT	43
	11	29	3.5	3	22.5-TT	43
	12	29	4	3	22-TT	43
	13	29	4	3	22-TT	43
	14	29	4	3	22-TT	43
	15	29	5	4	20-TT	43
	16	29	5	4	20-TT	43
	17	29	5	4	20-TT	43
	18	29	7.5	5	16.5-TT	43
	19	29	7.5	5	16.5-TT	43
	20	29	7.5	5	16.5-TT	43
Table 6.2.2.4.1-8a	1	29	2.5	2	24.5-TT	43
	2	29	2.5	2	24.5-TT	43
	3	29	2.5	2	24.5-TT	43
	4	29	2.5	2	24.5-TT	43
Table 6.2.2.4.1-9	1	29	3	2	24-TT	43
	2	29	3	2	24-TT	43
	3	29	3	2	24-TT	43
	4	29	3	2	24-TT	43
	5	29	3	2	24-TT	43
	6	29	3	2	24-TT	43
	7	29	4.5	4	20.5-TT	43
	8	29	4.5	4	20.5-TT	43
	9	29	4.5	4	20.5-TT	43
	10	29	6.5	5	17.5-TT	43
	11	29	6.5	5	17.5-TT	43
	12	29	6.5	5	17.5-TT	43
	13	29	5	4	20-TT	43
	14	29	5	4	20-TT	43
	15	29	5	4	20-TT	43
	16	29	6.5	5	17.5-TT	43
	17	29	6.5	5	17.5-TT	43
	18	29	6.5	5	17.5-TT	43
	19	29	9	5	15-TT	43
	20	29	9	5	15-TT	43
	21	29	9	5	15-TT	43

**Table 6.2.2.5-3: UE Power Class test requirements for Power Class 3 (n257, 258, 261)**

Test Configuration Table	Test ID	$P_{Powerclass}$	$MPR_{f,c}$	$T(MPR_{f,c})$	Lower limit (dBm)	Upper limit (dBm)
Table 6.2.2.4.1-7	1	22.4	2.5	2	17.9-TT- $\Delta MB_{P,n}$	43
	2	22.4	2.5	2	17.9-TT- $\Delta MB_{P,n}$	43
	3	22.4	2.5	2	17.9-TT- $\Delta MB_{P,n}$	43
	4	22.4	2.5	2	17.9-TT- $\Delta MB_{P,n}$	43
Table	1	22.4	2	1.5	18.9-TT- $\Delta MB_{P,n}$	43

6.2.2.4.1-8	2	22.4	2	1.5	18.9-TT- $\Delta MB_{P,n}$	43
	3	22.4	3	2	17.4-TT- $\Delta MB_{P,n}$	43
	4	22.4	3.5	3	15.9-TT- $\Delta MB_{P,n}$	43
	5	22.4	3.5	3	15.9-TT- $\Delta MB_{P,n}$	43
	6	22.4	3.5	3	15.9-TT- $\Delta MB_{P,n}$	43
	7	22.4	5	4	13.4-TT- $\Delta MB_{P,n}$	43
	8	22.4	5.5	5	11.9-TT- $\Delta MB_{P,n}$	43
	9	22.4	5.5	5	11.9-TT- $\Delta MB_{P,n}$	43
	10	22.4	5.5	5	11.9-TT- $\Delta MB_{P,n}$	43
	11	22.4	3.5	3	15.9-TT- $\Delta MB_{P,n}$	43
	12	22.4	4	3	15.4-TT- $\Delta MB_{P,n}$	43
	13	22.4	4	3	15.4-TT- $\Delta MB_{P,n}$	43
	14	22.4	4	3	15.4-TT- $\Delta MB_{P,n}$	43
	15	22.4	5	4	13.4-TT- $\Delta MB_{P,n}$	43
	16	22.4	5	4	13.4-TT- $\Delta MB_{P,n}$	43
	17	22.4	5	4	13.4-TT- $\Delta MB_{P,n}$	43
	18	22.4	7.5	5	9.9-TT- $\Delta MB_{P,n}$	43
	19	22.4	7.5	5	9.9-TT- $\Delta MB_{P,n}$	43
	20	22.4	7.5	5	9.9-TT- $\Delta MB_{P,n}$	43
	Table 6.2.2.4.1-8a	1	22.4	2.5	2	17.9-TT- $\Delta MB_{P,n}$
2		22.4	2.5	2	17.9-TT- $\Delta MB_{P,n}$	43
3		22.4	2.5	2	17.9-TT- $\Delta MB_{P,n}$	43
4		22.4	2.5	2	17.9-TT- $\Delta MB_{P,n}$	43
Table 6.2.2.4.1-9	1	22.4	3	2	17.4-TT- $\Delta MB_{P,n}$	43
	2	22.4	3	2	17.4-TT- $\Delta MB_{P,n}$	43
	3	22.4	3	2	17.4-TT- $\Delta MB_{P,n}$	43
	4	22.4	3	2	17.4-TT- $\Delta MB_{P,n}$	43
	5	22.4	3	2	17.4-TT- $\Delta MB_{P,n}$	43
	6	22.4	3	2	17.4-TT- $\Delta MB_{P,n}$	43
	7	22.4	4.5	4	13.9-TT- $\Delta MB_{P,n}$	43
	8	22.4	4.5	4	13.9-TT- $\Delta MB_{P,n}$	43
	9	22.4	4.5	4	13.9-TT- $\Delta MB_{P,n}$	43
	10	22.4	6.5	5	10.9-TT- $\Delta MB_{P,n}$	43
	11	22.4	6.5	5	10.9-TT- $\Delta MB_{P,n}$	43
	12	22.4	6.5	5	10.9-TT- $\Delta MB_{P,n}$	43
	13	22.4	5	4	13.4-TT- $\Delta MB_{P,n}$	43
	14	22.4	5	4	13.4-TT- $\Delta MB_{P,n}$	43
	15	22.4	5	4	13.4-TT- $\Delta MB_{P,n}$	43
	16	22.4	6.5	5	10.9-TT- $\Delta MB_{P,n}$	43
	17	22.4	6.5	5	10.9-TT- $\Delta MB_{P,n}$	43
	18	22.4	6.5	5	10.9-TT- $\Delta MB_{P,n}$	43
	19	22.4	9	5	8.4-TT- $\Delta MB_{P,n}$	43
	20	22.4	9	5	8.4-TT- $\Delta MB_{P,n}$	43
	21	22.4	9	5	8.4-TT- $\Delta MB_{P,n}$	43

Note 1:  $\Delta MB_{P,n}$  is the Multiband Relaxation factor declared by the UE for the tested band in table A.4.3.9-2 of TS38.508-2. This declaration shall fulfil the requirements in clause 6.2.1.1.3.3.

Note 2: All UE supported bands needs to be tested to ensure the multiband relaxation declaration is compliant.

Note 3: Max allowed sum of  $\Delta MB_{P,n}$  over all supported FR2 bands as defined in clause 6.2.1.1.3.3.

Note 4:  $\Delta MB_{P,n}$  is 0 for single band UE.

**Table 6.2.2.5-3a: UE Power Class test requirements for Power Class 3 (n260)**

Test Configuration Table	Test ID	P <sub>Powerclass</sub>	MPR <sub>f,c</sub>	T(MPR <sub>f,c</sub> )	Lower limit (dBm)	Upper limit (dBm)
Table 6.2.2.4.1-7	1	20.6	2.5	2	16.1-TT-ΔMB <sub>P,n</sub>	43
	2	20.6	2.5	2	16.1-TT-ΔMB <sub>P,n</sub>	43
	3	20.6	2.5	2	16.1-TT-ΔMB <sub>P,n</sub>	43
	4	20.6	2.5	2	16.1-TT-ΔMB <sub>P,n</sub>	43
Table 6.2.2.4.1-8	1	20.6	2	1.5	17.1-TT-ΔMB <sub>P,n</sub>	43
	2	20.6	2	1.5	17.1-TT-ΔMB <sub>P,n</sub>	43
	3	20.6	3	2	15.6-TT-ΔMB <sub>P,n</sub>	43
	4	20.6	3.5	3	14.1-TT-ΔMB <sub>P,n</sub>	43
	5	20.6	3.5	3	14.1-TT-ΔMB <sub>P,n</sub>	43
	6	20.6	3.5	3	14.1-TT-ΔMB <sub>P,n</sub>	43
	7	20.6	5	4	11.6-TT-ΔMB <sub>P,n</sub>	43
	8	20.6	5.5	5	10.1-TT-ΔMB <sub>P,n</sub>	43
	9	20.6	5.5	5	10.1-TT-ΔMB <sub>P,n</sub>	43
	10	20.6	5.5	5	10.1-TT-ΔMB <sub>P,n</sub>	43
	11	20.6	3.5	3	14.1-TT-ΔMB <sub>P,n</sub>	43
	12	20.6	4	3	13.6-TT-ΔMB <sub>P,n</sub>	43
	13	20.6	4	3	13.6-TT-ΔMB <sub>P,n</sub>	43
	14	20.6	4	3	13.6-TT-ΔMB <sub>P,n</sub>	43
	15	20.6	5	4	11.6-TT-ΔMB <sub>P,n</sub>	43
	16	20.6	5	4	11.6-TT-ΔMB <sub>P,n</sub>	43
	17	20.6	5	4	11.6-TT-ΔMB <sub>P,n</sub>	43
	18	20.6	7.5	5	8.1-TT-ΔMB <sub>P,n</sub>	43
	19	20.6	7.5	5	8.1-TT-ΔMB <sub>P,n</sub>	43
	20	20.6	7.5	5	8.1-TT-ΔMB <sub>P,n</sub>	43
Table 6.2.2.4.1-8a	1	20.6	2.5	2	16.1-TT-ΔMB <sub>P,n</sub>	43
	2	20.6	2.5	2	16.1-TT-ΔMB <sub>P,n</sub>	43
	3	20.6	2.5	2	16.1-TT-ΔMB <sub>P,n</sub>	43
	4	20.6	2.5	2	16.1-TT-ΔMB <sub>P,n</sub>	43
Table 6.2.2.4.1-9	1	20.6	3	2	15.6-TT-ΔMB <sub>P,n</sub>	43
	2	20.6	3	2	15.6-TT-ΔMB <sub>P,n</sub>	43
	3	20.6	3	2	15.6-TT-ΔMB <sub>P,n</sub>	43
	4	20.6	3	2	15.6-TT-ΔMB <sub>P,n</sub>	43
	5	20.6	3	2	15.6-TT-ΔMB <sub>P,n</sub>	43
	6	20.6	3	2	15.6-TT-ΔMB <sub>P,n</sub>	43
	7	20.6	4.5	4	12.1-TT-ΔMB <sub>P,n</sub>	43
	8	20.6	4.5	4	12.1-TT-ΔMB <sub>P,n</sub>	43
	9	20.6	4.5	4	12.1-TT-ΔMB <sub>P,n</sub>	43
	10	20.6	6.5	5	9.1-TT-ΔMB <sub>P,n</sub>	43
	11	20.6	6.5	5	9.1-TT-ΔMB <sub>P,n</sub>	43
	12	20.6	6.5	5	9.1-TT-ΔMB <sub>P,n</sub>	43
	13	20.6	5	4	11.6-TT-ΔMB <sub>P,n</sub>	43
	14	20.6	5	4	11.6-TT-ΔMB <sub>P,n</sub>	43
	15	20.6	5	4	11.6-TT-ΔMB <sub>P,n</sub>	43
	16	20.6	6.5	5	9.1-TT-ΔMB <sub>P,n</sub>	43

17	20.6	6.5	5	9.1-TT- $\Delta MB_{P,n}$	43
18	20.6	6.5	5	9.1-TT- $\Delta MB_{P,n}$	43
19	20.6	9	5	6.6-TT- $\Delta MB_{P,n}$	43
20	20.6	9	5	6.6-TT- $\Delta MB_{P,n}$	43
21	20.6	9	5	6.6-TT- $\Delta MB_{P,n}$	43

Note 1:  $\Delta MB_{P,n}$  is the Multiband Relaxation factor declared by the UE for the tested band in table A.4.3.9-2 of TS38.508-2. This declaration shall fulfil the requirements in clause 6.2.1.1.3.3.  
 Note 2: All UE supported bands needs to be tested to ensure the multiband relaxation declaration is compliant.  
 Note 3: Max allowed sum of  $\Delta MB_{P,n}$  over all supported FR2 bands as defined in clause 6.2.1.1.3.3.  
 Note 4:  $\Delta MB_{P,n}$  is 0 for single band UE.

**Table 6.2.2.5-3b: Test Tolerance (Power class 3)**

Test Metric	FR2a	FR2b
Max device size $\leq$ 30 cm	3.11 dB	3.11 dB

**Table 6.2.2.5-4: UE Power Class test requirements for Power Class 4 (n257, 258, 261)**

Test Configuration Table	Test ID	$P_{Powerclass}$	$MPR_{f,c}$	$T(MPR_{f,c})$	Lower limit (dBm)	Upper limit (dBm)
Table 6.2.2.4.1-7	1	34	2.5	2	29.5-TT	43
	2	34	2.5	2	29.5-TT	43
	3	34	2.5	2	29.5-TT	43
	4	34	2.5	2	29.5-TT	43
Table 6.2.2.4.1-8	1	34	2	1.5	30.5-TT	43
	2	34	2	1.5	30.5-TT	43
	3	34	3	2	29-TT	43
	4	34	3.5	3	27.5-TT	43
	5	34	3.5	3	27.5-TT	43
	6	34	3.5	3	27.5-TT	43
	7	34	5	4	25-TT	43
	8	34	5.5	5	23.5-TT	43
	9	34	5.5	5	23.5-TT	43
	10	34	5.5	5	23.5-TT	43
	11	34	3.5	3	27.5-TT	43
	12	34	4	3	27-TT	43
	13	34	4	3	27-TT	43
	14	34	4	3	27-TT	43
	15	34	5	4	25-TT	43
	16	34	5	4	25-TT	43
	17	34	5	4	25-TT	43
	18	34	7.5	5	1.5-TT	43
	19	34	7.5	5	1.5-TT	43
	20	34	7.5	5	1.5-TT	43
Table 6.2.2.4.1-8a	1	34	2.5	2	29.5-TT	43
	2	34	2.5	2	29.5-TT	43
	3	34	2.5	2	29.5-TT	43
	4	34	2.5	2	29.5-TT	43
Table 6.2.2.4.1-9	1	34	3	2	29-TT	43

2	34	3	2	29-TT	43
3	34	3	2	29-TT	43
4	34	3	2	29-TT	43
5	34	3	2	29-TT	43
6	34	3	2	29-TT	43
7	34	4.5	4	25.5-TT	43
8	34	4.5	4	25.5-TT	43
9	34	4.5	4	25.5-TT	43
10	34	6.5	5	22.5-TT	43
11	34	6.5	5	22.5-TT	43
12	34	6.5	5	22.5-TT	43
13	34	5	4	25-TT	43
14	34	5	4	25-TT	43
15	34	5	4	25-TT	43
16	34	6.5	5	22.5-TT	43
17	34	6.5	5	22.5-TT	43
18	34	6.5	5	22.5-TT	43
19	34	9	5	20-TT	43
20	34	9	5	20-TT	43
21	34	9	5	20-TT	43

**Table 6.2.2.5-4a: UE Power Class test requirements for Power Class 4 (n260)**

Test Configuration Table	Test ID	$P_{Powerclass}$	$MPR_{f,c}$	$T(MPR_{f,c})$	Lower limit (dBm)	Upper limit (dBm)
Table 6.2.2.4.1-7	1	31	2.5	2	26.5-TT	43
	2	31	2.5	2	26.5-TT	43
	3	31	2.5	2	26.5-TT	43
	4	31	2.5	2	26.5-TT	43
Table 6.2.2.4.1-8	1	31	2	1.5	27.5-TT	43
	2	31	2	1.5	27.5-TT	43
	3	31	3	2	26-TT	43
	4	31	3.5	3	24.5-TT	43
	5	31	3.5	3	24.5-TT	43
	6	31	3.5	3	24.5-TT	43
	7	31	5	4	22-TT	43
	8	31	5.5	5	20.5-TT	43
	9	31	5.5	5	20.5-TT	43
	10	31	5.5	5	20.5-TT	43
	11	31	3.5	3	24.5-TT	43
	12	31	4	3	24-TT	43
	13	31	4	3	24-TT	43
	14	31	4	3	24-TT	43
	15	31	5	4	22-TT	43
16	31	5	4	22-TT	43	
17	31	5	4	22-TT	43	
18	31	7.5	5	18.5-TT	43	
19	31	7.5	5	18.5-TT	43	

	20	31	7.5	5	18.5-TT	43
Table 6.2.2.4.1-8a	1	31	2.5	2	26.5-TT	43
	2	31	2.5	2	26.5-TT	43
	3	31	2.5	2	26.5-TT	43
	4	31	2.5	2	26.5-TT	43
Table 6.2.2.4.1-9	1	31	3	2	26-TT	43
	2	31	3	2	26-TT	43
	3	31	3	2	26-TT	43
	4	31	3	2	26-TT	43
	5	31	3	2	26-TT	43
	6	31	3	2	26-TT	43
	7	31	4.5	4	22.5-TT	43
	8	31	4.5	4	22.5-TT	43
	9	31	4.5	4	22.5-TT	43
	10	31	6.5	5	19.5-TT	43
	11	31	6.5	5	19.5-TT	43
	12	31	6.5	5	19.5-TT	43
	13	31	5	4	22-TT	43
	14	31	5	4	22-TT	43
	15	31	5	4	22-TT	43
	16	31	6.5	5	19.5-TT	43
	17	31	6.5	5	19.5-TT	43
	18	31	6.5	5	19.5-TT	43
	19	31	9	5	17-TT	43
	20	31	9	5	17-TT	43
	21	31	9	5	17-TT	43

## 6.2.2\_1 UE maximum output power reduction enhancements

Editor's note: The following aspects are either missing or not yet determined:

- Measurement Uncertainties and Test Tolerances are FFS for PC1, PC2 and PC4.
- Measurement grid for PC2/4 in Annex M.4 is FFS.
- Applicability of *modifiedMPRbehaviour* bit 0 to PC2, PC4 and PC5 is FFS

### 6.2.2\_1.0 General

The requirements in section 6.2.2 only apply when both UL and DL of a UE are configured for single CC operation, and they are of the same bandwidth. A UE may reduce its maximum output power due to modulation orders, transmit bandwidth configurations, waveform types and narrow allocations. This Maximum Power Reduction (MPR) is defined in subclauses below. The allowed MPR for SRS, PUCCH formats 0, 1, 3 and 4, and PRACH shall be as specified for QPSK modulated DFT-s-OFDM of equivalent RB allocation. The allowed MPR for PUCCH format 2 shall be as specified for QPSK modulated CP-OFDM of equivalent RB allocation. When the maximum output power of a UE is modified by MPR, the power limits specified in subclause 6.2.4 apply.

For a UE that is configured for single CC operation with different channel bandwidths in UL and DL, the requirements in section 6.2A.2 apply.

For all power classes, the waveform defined by BW = 100 MHz, SCS = 120 kHz, DFT-S-OFDM QPSK, 20RB23 is the reference waveform with 0 dB MPR and is used for the power class definition.

## 6.2.2\_1.1 Test purpose

The number of RB identified in 6.2.2.3 is based on meeting the requirements for the maximum power reduction (MPR) due to Cubic Metric (CM).

## 6.2.2\_1.2 Test applicability

The requirements of this test apply to all types of Rel-15 PC3 devices which supports *modifiedMPRbehaviour* bit 0 capability (according to Annex P.1) and Rel-16 and forward PC3 devices.

## 6.2.2\_1.3 Minimum conformance requirements

## 6.2.2\_1.3.1 FFS

## 6.2.2\_1.3.2 FFS

## 6.2.2\_1.3.3 UE maximum output power reduction for power class 3

For transmission bandwidth configuration less than or equal to 200MHz, and  $0 \leq RB_{start} < \text{Ceil}(1/3 N_{RB})$  or  $\text{Ceil}((2/3N_{RB}) L_{CRB}) < RB_{start} \leq N_{RB} - L_{CRB}$ :

- $MPR_{narrow} = 2.5$  dB, when  $BW_{alloc,RB}$  is less than or equal to 1.44 MHz,
- $MPR_{narrow} = 2.0$  dB, when  $1.44 \text{ MHz} < BW_{alloc,RB} \leq 4.32 \text{ MHz}$ ,
- otherwise  $MPR_{narrow} = 0$  dB.

$MPR_{WT}$  is the maximum power reduction due to modulation orders, transmission bandwidth configurations listed in Table 5.3.2-1, and waveform types.  $MPR_{WT}$  is defined in Table 6.2.2\_1.3.3-1.

**Table 6.2.2\_1.3.3-1  $MPR_{WT}$  for power class 3,  $BW_{channel} \leq 200$  MHz**

Modulation		$MPR_{WT}, BW_{channel} \leq 200$ MHz	
		Inner RB allocations, Region 1	Edge RB allocations
DFT-s-OFDM	Pi/2 BPSK	0.0	$\leq 2.0$
	QPSK	0.0	$\leq 2.0$
	16 QAM	$\leq 3.0$	$\leq 3.5$
	64 QAM	$\leq 5.0$	$\leq 5.5$
CP-OFDM	QPSK	$\leq 3.5$	$\leq 4.0$
	16 QAM	$\leq 5.0$	$\leq 5.0$
	64 QAM	$\leq 7.5$	$\leq 7.5$

Where the following parameters are defined to specify valid RB allocation ranges for RB allocations in Table 6.2.2\_1.3.3-1:

- $RB_{Start,Low} = \max(1, L_{CRB})$ , where  $\max()$  indicates the largest value of all arguments.
- $RB_{Start,High} = N_{RB} - RB_{Start,Low} - L_{CRB}$ .

An RB allocation belonging to table 6.2.2\_1.3.3-1 is a Region 1 inner RB allocation if:

- $RB_{Start,Low} \leq RB_{Start} \leq RB_{Start,High}$ , and  $L_{CRB} \leq \text{ceil}(N_{RB}/3)$ , where  $\text{ceil}(x)$  is the smallest integer greater than or equal to  $x$ .

For transmission bandwidth configuration equal to 400MHz,

$MPR_{narrow} = 2.5$  dB, when  $BW_{alloc,RB}$  is less than or equal to 1.44 MHz, and  $0 \leq RB_{start} < \text{Ceil}(1/3 N_{RB})$  or  $\text{Ceil}(2/3N_{RB}) \leq RB_{start} \leq N_{RB} - L_{CRB}$ , where  $BW_{alloc,RB}$  is the bandwidth of the RB allocation size.

$MPR_{WT}$  is the maximum power reduction due to modulation orders, transmission bandwidth configurations listed in Table 5.3.2-1, and waveform types.  $MPR_{WT}$  is defined in Table 6.2.2\_1.3.3-2.

**Table 6.2.2\_1.3.3-2 MPR<sub>WT</sub> for power class 3, BW<sub>channel</sub> = 400 MHz**

Modulation		MPR <sub>WT</sub> , BW <sub>channel</sub> = 400 MHz	
		Inner RB allocations, Region 1	Edge RB allocations
DFT-s-OFDM	Pi/2 BPSK	0.0	≤ 3.0
	QPSK	0.0	≤ 3.0
	16 QAM	≤ 4.5	≤ 4.5
	64 QAM	≤ 6.5	≤ 6.5
CP-OFDM	QPSK	≤ 5.0	≤ 5.0
	16 QAM	≤ 6.5	≤ 6.5
	64 QAM	≤ 9.0	≤ 9.0

Where the following parameters are defined to specify valid RB allocation ranges for RB allocations in Table 6.2.2\_1.3.3-2:

N<sub>RB</sub> is the maximum number of RBs for a given Channel bandwidth and sub-carrier spacing defined in Table 5.3.2-1.

$$RB_{end} = RB_{Start} + L_{CRB} - 1$$

An RB allocation belonging to table 6.2.2\_1.3.3-2 is a Region 1 inner RB allocation if

$$RB_{start} \geq Ceil(1/4 N_{RB}) \text{ AND } RB_{end} < Ceil(3/4 N_{RB}) \text{ AND } L_{CRB} \leq Ceil(1/4 N_{RB})$$

For all transmission bandwidth configurations, an RB allocation is an Edge allocation if it is NOT a Region 1 inner allocation.

The normative reference for this requirement is TS 38.101-2 [3] clause 6.2.2.3

6.2.2\_1.3.4 FFS

6.2.2\_1.4 Test description

Same as in clause 6.2.2.1.4.1 with following exceptions: Instead of Tables 6.2.2.1.4.1-1 to 6.2.2.1.4.1-9 →use Tables 6.2.2\_1.1.4.1-1 and 6.2.2\_1.1.4.1-4

**Table 6.2.2\_1.4.1-1: Test Configuration Table (Power Class 3, MPR<sub>narrow</sub>, BW<sub>channel</sub> ≤ 200 MHz)**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal, TL, TH			
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1			Low range, High range			
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1			Lowest and Highest supported channel bandwidth that ≤ 200 MHz			
Test SCS as specified in Table 5.3.5-1			Lowest, Highest			
Test Parameters						
Test ID	Freq	ChBw	SCS	Downlink Configuration	Uplink Configuration	
					Modulation	RB allocation (NOTE 1)
1	Low	Default	Default	-	DFT-s-OFDM Pi/2 BPSK	Outer_1RB_Left
2	High				DFT-s-OFDM Pi/2 BPSK	Outer_1RB_Right
3	Low				DFT-s-OFDM QPSK	Outer_1RB_Left
4	High				DFT-s-OFDM QPSK	Outer_1RB_Right
5	Low				DFT-s-OFDM Pi/2 BPSK	Inner_Partial2_Left
6	High				DFT-s-OFDM Pi/2 BPSK	Inner_Partial2_Right
7	Low				DFT-s-OFDM QPSK	Inner_Partial2_Left
8	High				DFT-s-OFDM QPSK	Inner_Partial2_Right
NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-1.						



**Table 6.2.2\_1.4.1-2: Test Configuration Table (Power Class 3, MPR<sub>WT</sub>, BW<sub>channel</sub> ≤ 200 MHz)**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal, TL, TH		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1				Low range, Mid range, High range		
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1				Lowest and Highest supported channel bandwidth that ≤ 200 MHz		
Test SCS as specified in Table 5.3.5-1				Lowest, Highest		
Test Parameters						
Test ID	Freq	ChBw	SCS	Downlink Configuration	Uplink Configuration	
		Default	Default	-	Modulation	RB allocation (NOTE 1)
1	Mid				DFT-s-OFDM PI/2 BPSK	Outer_Full
2	Mid				DFT-s-OFDM QPSK	Outer_Full
3	Mid				DFT-s-OFDM 16 QAM	Inner_Full
4	Low				DFT-s-OFDM 16 QAM	Outer_1RB_Left
5	High				DFT-s-OFDM 16 QAM	Outer_1RB_Right
6	Mid				DFT-s-OFDM 16 QAM	Outer_Full
7	Mid				DFT-s-OFDM 64 QAM	Inner_Full
8	Low				DFT-s-OFDM 64 QAM	Outer_1RB_Left
9	High				DFT-s-OFDM 64 QAM	Outer_1RB_Right
10	Mid				DFT-s-OFDM 64 QAM	Outer_Full
11	Mid				CP-OFDM QPSK	Inner_Full
12	Low				CP-OFDM QPSK	Outer_1RB_Left
13	High				CP-OFDM QPSK	Outer_1RB_Right
14	Mid				CP-OFDM QPSK	Outer_Full
15	Low				CP-OFDM 16 QAM	Outer_1RB_Left
16	High				CP-OFDM 16 QAM	Outer_1RB_Right
17	Mid				CP-OFDM 16 QAM	Outer_Full
18	Low				CP-OFDM 64 QAM	Outer_1RB_Left
19	High				CP-OFDM 64 QAM	Outer_1RB_Right
20	Mid	CP-OFDM 64 QAM	Outer_Full			
NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-1.						

**Table 6.2.2\_1.4.1-3: Test Configuration Table (Power Class 3, MPR<sub>narrow</sub>, BW<sub>channel</sub> = 400 MHz)**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal, TL, TH		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1				Low range, High range		
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1				400 MHz		
Test SCS as specified in Table 5.3.5-1				120 kHz		
Test Parameters						
Test ID	Freq	ChBw	SCS	Downlink Configuration	Uplink Configuration	
		Default	Default	N/A for Maximum Power Reduction (MPR) test case	Modulation	RB allocation (NOTE 1)
1	Low				DFT-s-OFDM PI/2 BPSK	Inner_1RB_Left
2	High				DFT-s-OFDM PI/2 BPSK	Inner_1RB_Right
3	Low				DFT-s-OFDM QPSK	Inner_1RB_Left
4	High				DFT-s-OFDM QPSK	Inner_1RB_Right
NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-1.						

**Table 6.2.2\_1.4.1-4: Test Configuration Table (Power Class 3, MPR<sub>WT</sub>, BW<sub>channel</sub> = 400 MHz)**

Default Conditions	
Test Environment as specified in TS 38.508-1 [10]	Normal, TL, TH

subclause 4.1						
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1		Low range, Mid range, High range				
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1		400 MHz				
Test SCS as specified in Table 5.3.5-1		120kHz				
Test Parameters						
Test ID	Freq	ChBw	SCS	Downlink Configuration	Uplink Configuration	
					Modulation	RB allocation (NOTE 1)
1	Low	Default	Default	-	DFT-s-OFDM PI/2 BPSK	Outer_1RB_Left
2	High				DFT-s-OFDM PI/2 BPSK	Outer_1RB_Right
3	Mid				DFT-s-OFDM PI/2 BPSK	Outer_Full
4	Low				DFT-s-OFDM QPSK	Outer_1RB_Left
5	High				DFT-s-OFDM QPSK	Outer_1RB_Right
6	Mid				DFT-s-OFDM QPSK	Outer_Full
7	Low				DFT-s-OFDM 16 QAM	Outer_1RB_Left
8	High				DFT-s-OFDM 16 QAM	Outer_1RB_Right
9	Mid				DFT-s-OFDM 16 QAM	Outer_Full
10	Low				DFT-s-OFDM 64 QAM	Outer_1RB_Left
11	High				DFT-s-OFDM 64 QAM	Outer_1RB_Right
12	Mid				DFT-s-OFDM 64 QAM	Outer_Full
13	Low				CP-OFDM QPSK	Outer_1RB_Left
14	High				CP-OFDM QPSK	Outer_1RB_Right
15	Mid				CP-OFDM QPSK	Outer_Full
16	Low				CP-OFDM 16 QAM	Outer_1RB_Left
17	High				CP-OFDM 16 QAM	Outer_1RB_Right
18	Mid				CP-OFDM 16 QAM	Outer_Full
19	Low				CP-OFDM 64 QAM	Outer_1RB_Left
20	High				CP-OFDM 64 QAM	Outer_1RB_Right
21	Mid				CP-OFDM 64 QAM	Outer_Full
NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-1.						

6.2.2.5 Test requirement

The maximum output power, derived in step 5 shall be within the range prescribed by the nominal maximum output power and tolerance in following tables.

**Table 6.2.2\_1.5-1: UE Power Class test requirements for Power Class 3 (n257, 258, 261)**

Test Configuration Table	Test ID	P <sub>Powerclass</sub>	MPR <sub>f,c</sub>	T(MPR <sub>f,c</sub> )	Lower limit (dBm)	Upper limit (dBm)
6.2.2_1.4.1-1	1	22.4	2.5	2	17.9-TT-ΔMB <sub>P,n</sub>	43
	2	22.4	2.5	2	17.9-TT-ΔMB <sub>P,n</sub>	43
	3	22.4	2.5	2	17.9-TT-ΔMB <sub>P,n</sub>	43
	4	22.4	2.5	2	17.9-TT-ΔMB <sub>P,n</sub>	43
	5	22.4	2	1.5	18.9-TT-ΔMB <sub>P,n</sub>	43
	6	22.4	2	1.5	18.9-TT-ΔMB <sub>P,n</sub>	43
	7	22.4	2	1.5	18.9-TT-ΔMB <sub>P,n</sub>	43
	8	22.4	2	1.5	18.9-TT-ΔMB <sub>P,n</sub>	43
6.2.2_1.4.1-2	1	22.4	2	1.5	18.9-TT-ΔMB <sub>P,n</sub>	43
	2	22.4	2	1.5	18.9-TT-ΔMB <sub>P,n</sub>	43
	3	22.4	3	2	17.4-TT-ΔMB <sub>P,n</sub>	43
	4	22.4	3.5	3	15.9-TT-ΔMB <sub>P,n</sub>	43

	5	22.4	3.5	3	15.9-TT- $\Delta MB_{P,n}$	43
	6	22.4	3.5	3	15.9-TT- $\Delta MB_{P,n}$	43
	7	22.4	5	4	13.4-TT- $\Delta MB_{P,n}$	43
	8	22.4	5.5	5	11.9-TT- $\Delta MB_{P,n}$	43
	9	22.4	5.5	5	11.9-TT- $\Delta MB_{P,n}$	43
	10	22.4	5.5	5	11.9-TT- $\Delta MB_{P,n}$	43
	11	22.4	3.5	3	15.9-TT- $\Delta MB_{P,n}$	43
	12	22.4	4	3	15.4-TT- $\Delta MB_{P,n}$	43
	13	22.4	4	3	15.4-TT- $\Delta MB_{P,n}$	43
	14	22.4	4	3	15.4-TT- $\Delta MB_{P,n}$	43
	15	22.4	5	4	13.4-TT- $\Delta MB_{P,n}$	43
	16	22.4	5	4	13.4-TT- $\Delta MB_{P,n}$	43
	17	22.4	5	4	13.4-TT- $\Delta MB_{P,n}$	43
	18	22.4	7.5	5	9.9-TT- $\Delta MB_{P,n}$	43
	19	22.4	7.5	5	9.9-TT- $\Delta MB_{P,n}$	43
	20	22.4	7.5	5	9.9-TT- $\Delta MB_{P,n}$	43
6.2.2_1.4.1-3	1	22.4	2.5	2	17.9-TT- $\Delta MB_{P,n}$	43
	2	22.4	2.5	2	17.9-TT- $\Delta MB_{P,n}$	43
	3	22.4	2.5	2	17.9-TT- $\Delta MB_{P,n}$	43
	4	22.4	2.5	2	17.9-TT- $\Delta MB_{P,n}$	43
6.2.2_1.4.1-4	1	22.4	3	2	17.4-TT- $\Delta MB_{P,n}$	43
	2	22.4	3	2	17.4-TT- $\Delta MB_{P,n}$	43
	3	22.4	3	2	17.4-TT- $\Delta MB_{P,n}$	43
	4	22.4	3	2	17.4-TT- $\Delta MB_{P,n}$	43
	5	22.4	3	2	17.4-TT- $\Delta MB_{P,n}$	43
	6	22.4	3	2	17.4-TT- $\Delta MB_{P,n}$	43
	7	22.4	4.5	4	13.9-TT- $\Delta MB_{P,n}$	43
	8	22.4	4.5	4	13.9-TT- $\Delta MB_{P,n}$	43
	9	22.4	4.5	4	13.9-TT- $\Delta MB_{P,n}$	43
	10	22.4	6.5	5	10.9-TT- $\Delta MB_{P,n}$	43
	11	22.4	6.5	5	10.9-TT- $\Delta MB_{P,n}$	43
	12	22.4	6.5	5	10.9-TT- $\Delta MB_{P,n}$	43
	13	22.4	5	4	13.4-TT- $\Delta MB_{P,n}$	43
	14	22.4	5	4	13.4-TT- $\Delta MB_{P,n}$	43
	15	22.4	5	4	13.4-TT- $\Delta MB_{P,n}$	43
	16	22.4	6.5	5	10.9-TT- $\Delta MB_{P,n}$	43
	17	22.4	6.5	5	10.9-TT- $\Delta MB_{P,n}$	43
	18	22.4	6.5	5	10.9-TT- $\Delta MB_{P,n}$	43
	19	22.4	9	5	8.4-TT- $\Delta MB_{P,n}$	43
	20	22.4	9	5	8.4-TT- $\Delta MB_{P,n}$	43
	21	22.4	9	5	8.4-TT- $\Delta MB_{P,n}$	43
Note 1:	$\Delta MB_{P,n}$ is the Multiband Relaxation factor declared by the UE for the tested band in table A.4.3.9-2 of TS38.508-2. This declaration shall fulfil the requirements in clause 6.2.1.1.3.3.					
Note 2:	All UE supported bands needs to be tested to ensure the multiband relaxation declaration is compliant.					
Note 3:	Max allowed sum of $\Delta MB_{P,n}$ over all supported FR2 bands as defined in clause 6.2.1.1.3.3.					
Note 4:	$\Delta MB_{P,n}$ is 0 for single band UE.					

**Table 6.2.2\_1.5-2: UE Power Class test requirements for Power Class 3 (n260)**

Test Configuration Table	Test ID	P <sub>Powerclass</sub>	MPR <sub>f,c</sub>	T(MPR <sub>f,c</sub> )	Lower limit (dBm)	Upper limit (dBm)
6.2.2_1.4.1-1	1	20.6	2.5	2	16.1-TT-ΔMB <sub>P,n</sub>	43
	2	20.6	2.5	2	16.1-TT-ΔMB <sub>P,n</sub>	43
	3	20.6	2.5	2	16.1-TT-ΔMB <sub>P,n</sub>	43
	4	20.6	2.5	2	16.1-TT-ΔMB <sub>P,n</sub>	43
	5	20.6	2	1.5	17.1-TT-ΔMB <sub>P,n</sub>	43
	6	20.6	2	1.5	17.1-TT-ΔMB <sub>P,n</sub>	43
	7	20.6	2	1.5	17.1-TT-ΔMB <sub>P,n</sub>	43
	8	20.6	2	1.5	17.1-TT-ΔMB <sub>P,n</sub>	43
6.2.2_1.4.1-2	1	20.6	2	1.5	17.1-TT-ΔMB <sub>P,n</sub>	43
	2	20.6	2	1.5	17.1-TT-ΔMB <sub>P,n</sub>	43
	3	20.6	3	2	15.6-TT-ΔMB <sub>P,n</sub>	43
	4	20.6	3.5	3	14.1-TT-ΔMB <sub>P,n</sub>	43
	5	20.6	3.5	3	14.1-TT-ΔMB <sub>P,n</sub>	43
	6	20.6	3.5	3	14.1-TT-ΔMB <sub>P,n</sub>	43
	7	20.6	5	4	11.6-TT-ΔMB <sub>P,n</sub>	43
	8	20.6	5.5	5	10.1-TT-ΔMB <sub>P,n</sub>	43
	9	20.6	5.5	5	10.1-TT-ΔMB <sub>P,n</sub>	43
	10	20.6	5.5	5	10.1-TT-ΔMB <sub>P,n</sub>	43
	11	20.6	3.5	3	14.1-TT-ΔMB <sub>P,n</sub>	43
	12	20.6	4	3	13.6-TT-ΔMB <sub>P,n</sub>	43
	13	20.6	4	3	13.6-TT-ΔMB <sub>P,n</sub>	43
	14	20.6	4	3	13.6-TT-ΔMB <sub>P,n</sub>	43
	15	20.6	5	4	11.6-TT-ΔMB <sub>P,n</sub>	43
	16	20.6	5	4	11.6-TT-ΔMB <sub>P,n</sub>	43
	17	20.6	5	4	11.6-TT-ΔMB <sub>P,n</sub>	43
	18	20.6	7.5	5	8.1-TT-ΔMB <sub>P,n</sub>	43
	19	20.6	7.5	5	8.1-TT-ΔMB <sub>P,n</sub>	43
	20	20.6	7.5	5	8.1-TT-ΔMB <sub>P,n</sub>	43
6.2.2_1.4.1-3	1	20.6	2.5	2	16.1-TT-ΔMB <sub>P,n</sub>	43
	2	20.6	2.5	2	16.1-TT-ΔMB <sub>P,n</sub>	43
	3	20.6	2.5	2	16.1-TT-ΔMB <sub>P,n</sub>	43
	4	20.6	2.5	2	16.1-TT-ΔMB <sub>P,n</sub>	43
6.2.2_1.4.1-4	1	20.6	3	2	15.6-TT-ΔMB <sub>P,n</sub>	43
	2	20.6	3	2	15.6-TT-ΔMB <sub>P,n</sub>	43
	3	20.6	3	2	15.6-TT-ΔMB <sub>P,n</sub>	43
	4	20.6	3	2	15.6-TT-ΔMB <sub>P,n</sub>	43
	5	20.6	3	2	15.6-TT-ΔMB <sub>P,n</sub>	43
	6	20.6	3	2	15.6-TT-ΔMB <sub>P,n</sub>	43
	7	20.6	4.5	4	12.1-TT-ΔMB <sub>P,n</sub>	43
	8	20.6	4.5	4	12.1-TT-ΔMB <sub>P,n</sub>	43
	9	20.6	4.5	4	12.1-TT-ΔMB <sub>P,n</sub>	43
	10	20.6	6.5	5	9.1-TT-ΔMB <sub>P,n</sub>	43
	11	20.6	6.5	5	9.1-TT-ΔMB <sub>P,n</sub>	43
	12	20.6	6.5	5	9.1-TT-ΔMB <sub>P,n</sub>	43

13	20.6	5	4	11.6-TT- $\Delta MB_{P,n}$	43
14	20.6	5	4	11.6-TT- $\Delta MB_{P,n}$	43
15	20.6	5	4	11.6-TT- $\Delta MB_{P,n}$	43
16	20.6	6.5	5	9.1-TT- $\Delta MB_{P,n}$	43
17	20.6	6.5	5	9.1-TT- $\Delta MB_{P,n}$	43
18	20.6	6.5	5	9.1-TT- $\Delta MB_{P,n}$	43
19	20.6	9	5	6.6-TT- $\Delta MB_{P,n}$	43
20	20.6	9	5	6.6-TT- $\Delta MB_{P,n}$	43
21	20.6	9	5	6.6-TT- $\Delta MB_{P,n}$	43

Note 1:  $\Delta MB_{P,n}$  is the Multiband Relaxation factor declared by the UE for the tested band in table A.4.3.9-2 of TS38.508-2. This declaration shall fulfil the requirements in clause 6.2.1.1.3.3.

Note 2: All UE supported bands needs to be tested to ensure the multiband relaxation declaration is compliant.

Note 3: Max allowed sum of  $\Delta MB_{P,n}$  over all supported FR2 bands as defined in clause 6.2.1.1.3.3.

Note 4:  $\Delta MB_{P,n}$  is 0 for single band UE.

Table 6.2.2\_1.5-3: Test Tolerance (Power class 3)

Test Metric	FR2a	FR2b
Max device size $\leq$ 30 cm	3.11 dB	3.11 dB

## 6.2.3 UE maximum output power with additional requirements

Editor's note: The following aspects are either missing or not yet determined:

- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.

### 6.2.3.1 Test purpose

Additional spectrum emission requirements can be signalled by the network to indicate that the UE shall also meet additional requirements in a specific deployment scenario. To meet these additional requirements, Additional Maximum Power Reduction (A-MPR) is allowed for the output power.

### 6.2.3.2 Test applicability

This test case applies to all types of NR UE release 15 and forward.

### 6.2.3.3 Minimum conformance requirements

#### 6.2.3.3.1 General

Additional emission requirements can be signalled by the network. Each additional emission requirement is associated with a unique network signalling (NS) value indicated in RRC signalling by an NR frequency band number of the applicable operating band and an associated value in the field *additionalSpectrumEmission*. Throughout this specification, the notion of indication or signalling of an NS value refers to the corresponding indication of an NR frequency band number of the applicable operating band (the IE field *freqBandIndicatorNR*) and an associated value of *additionalSpectrumEmission* in the relevant RRC information elements.

To meet these additional requirements, additional maximum power reduction (A-MPR) is allowed for the maximum output power as specified in subclause 6.2.1.1.3. Unless stated otherwise, an A-MPR of 0 dB shall be used.

Table 6.2.3.3.1-1 specifies the additional requirements with their associated network signalling values and the allowed A-MPR and applicable operating band(s) for each NS value. The mapping of NR frequency band numbers and values of the *additionalSpectrumEmission* to network signalling labels is specified in Table 6.2.3.3.1-2. Unless otherwise stated, the allowed total back off is maximum of A-MPR and MPR specified in subclause 6.2.2.

**Table 6.2.3.3.1-1: Additional maximum power reduction (A-MPR)**

Network Signalling label	Requirements (subclause)	NR Band	Channel bandwidth (MHz)	Resources Blocks ( $N_{RB}$ )	A-MPR (dB)
NS_200					N/A
NS_201 (NOTE 1)	6.5.3.3.3	n258			6.2.3.3.2
NS_202	6.5.3.3.3	n257, n258	50, 100, 200, 400	Table 5.3.2-1	6.2.3.3.3
NS_203	6.5.3.3.3	n258	50, 100, 200, 400	Table 5.3.2-1	6.2.3.3.4
NOTE 1: NS_201 is obsolete, the associated additional spurious emission requirements are not applicable.					

**Table 6.2.3.3.1-2: Mapping of Network Signalling label**

NR Band	Value of <i>additionalSpectrumEmission</i> (NOTE 1)							
	0	1	2	3	4	5	6	7
n257	NS_200	NS_202						
n258	NS_200	NS_201 <sup>2</sup>	NS_202	NS_203				
n260	NS_200							
n261	NS_200							
NOTE 1: <i>additionalSpectrumEmission</i> corresponds to an information element of the same name defined in sub-clause 6.3.2 of TS 38.331 [19].								
NOTE 2: NS_201 is obsolete, the associated additional spurious emission requirements are not applicable.								

The normative reference for this requirement is TS 38.101-2 [3] clause 6.2.3.1.

#### 6.2.3.3.2 Void

##### 6.2.3.3.2.1 Void

##### 6.2.3.3.2.2 Void

##### 6.2.3.3.2.3 Void

#### 6.2.3.3.3 A-MPR for NS\_202

##### 6.2.3.3.3.1 A-MPR for NS\_202 for power class 1

For power class 1, A-MPR for NS\_202 shall be 11.0 dB.

##### 6.2.3.3.3.2 A-MPR for NS\_202 for power class 2

For power class 2, A-MPR for NS\_202 specified in clause 6.2.3.3.3.3 applies.

##### 6.2.3.3.3.3 A-MPR for NS\_202 for power class 3

For power class 3, A-MPR for NS\_202 shall be 1.0 dB.

##### 6.2.3.3.3.4 A-MPR for NS\_202 for power class 4

For power class 4, A-MPR for NS\_202 specified in clause 6.2.3.3.3.3 applies.

The normative reference for this requirement is TS 38.101-2 [3] clause 6.2.3.3.

6.2.3.3.3.5 Void

6.2.3.3.3.6 A-MPR for NS\_202 for power class 6

For power class 6, A-MPR for NS\_202 specified in clause 6.2.3.3.3.3 applies.

6.2.3.3.4 A-MPR for NS\_203

6.2.3.3.4.1 A-MPR for NS\_203 for power class 1

For power class 1, A-MPR for NS\_203 shall be 3.0 dB if Offset frequency <  $BW_{channel}$ , 0.0 dB otherwise.  
The Offset frequency is defined as the frequency from 24.25 GHz to the lower edge of the channel bandwidth.

6.2.3.3.4.2 A-MPR for NS\_203 for power class 2

For power class 2, A-MPR for NS\_203 specified in clause 6.2.3.3.4.3 applies.

6.2.3.3.4.3 A-MPR for NS\_203 for power class 3

For power class 3, A-MPR for NS\_203 shall be 0 dB.

6.2.3.3.4.4 A-MPR for NS\_203 for power class 4

For power class 4, A-MPR for NS\_203 specified in clause 6.2.3.3.4.3 applies.

The normative reference for this requirement is TS 38.101-2 [3] clause 6.2.3.4.

6.2.3.3.4.5 Void

6.2.3.3.4.6 A-MPR for NS\_203 for power class 6

For power class 6, AMPR for NS\_203 specified in subclause 6.2.3.3.4.3 applies.

6.2.3.4 Test description

6.2.3.4.1 Initial conditions

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, and channel bandwidths based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each channel bandwidth and subcarrier spacing, are shown in Table 6.2.3.4.1-2 to Table 6.2.3.4.1-3. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.2.3.4.1-1: Void**

**Table 6.2.3.4.1-2: Test configuration table for NS\_202**

Initial Conditions	
Test Environment as specified in TS 38.508-1 [10] subclause 4.1	Normal
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1	Low range, High range
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1	Highest
Test SCS as specified in Table 5.3.5-1	120kHz

Test Parameters			
Test ID	Downlink Configuration	Uplink Configuration	
		Modulation	RB allocation (NOTE 1)
1 (NOTE 4)		DFT-s-OFDM QPSK	Inner_Full
2		DFT-s-OFDM QPSK	Inner_1RB_Left for PC2, PC3 and PC4 Inner_Partial for PC1 (NOTE 2)
3 (NOTE 3)		DFT-s-OFDM 64QAM	Outer_Full

NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.

NOTE 2: When testing Low range configure uplink RB to Inner\_1RB\_Left for PC2, PC3 and PC4 or Inner\_Partial\_Left\_Region1 for PC1 and when testing High range configure uplink RB to Inner\_1RB\_Right for PC2, PC3 and PC4 or Inner\_Partial\_Right\_Region1 for PC1.

NOTE 3: Test ID only applicable to PC1

NOTE 4: Test ID only applicable to PC2, PC3 and PC4

**Table 6.2.3.4.1-3: Test configuration table for NS\_203**

Initial Conditions					
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1				Low range	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1				Highest	
Test SCS as specified in Table 5.3.5-1				120kHz	
Test Parameters					
Test ID	Frequency	Channel Bandwidth	Downlink Configuration	Uplink Configuration	
				Modulation	
				RB allocation (NOTE 1)	
1	Default	Default		DFT-s-OFDM QPSK	Inner_Full
2	Default	Default		DFT-s-OFDM QPSK	Inner_1RB_Left for PC2, PC3 and PC4 Inner_Partial_Left_Region1 for PC1
3 (NOTE 2)	Low range + Channel Bandwidth (NOTE 3)	Default		DFT-s-OFDM QPSK	Inner_Partial_Left_Region1

NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.

NOTE 2: Test ID only applicable to PC1

NOTE 3: Test frequencies for test ID 3 is specified in Table 6.2.3.4.1-4.



Table 6.2.3.4.1-4: NS\_203 test ID3 test frequencies for NR operating band n258, SCS 120kHz and  $\Delta F_{\text{Raster}}$  120 kHz

CBW [MHz]	carrier Bandwidth [PRBs]	Range		Carrier centre [MHz]	Carrier centre [ARFCN]	point A [MHz]	absolute FrequencyPoint A [ARFCN]	offsetTo Carrier [Carrier PRBs]	SS block SCS [kHz]	GSCN	absolute FrequencySSB [ARFCN]	$k_{\text{SSB}}$	Offset Carrier CORE SET#0 [RBs] Note 2	CORE SET#0 Index (Offset [RBs]) Note 1	offsetTo PointA (SIB1) [PRBs] Note 1
50	32	Downlink & Uplink	Low + CHBW	24325.02	2017916	24301.98	2017532	0	120	22260	2017819	11	1	0 (0)	2
100	66	Downlink & Uplink	Low + CHBW	24400.02	2019166	24352.5	2018374	0	120	22263	2018683	10	1	0 (0)	4
200	132	Downlink & Uplink	Low + CHBW	24550.02	2021666	24454.98	2020082	0	120	22269	2020411	8	1	0 (0)	6
400	264	Downlink & Uplink	Low + CHBW	24850.02	2026666	24659.94	2023498	0	120	22281	2023867	4	1	1 (4)	10
<p>Note 1: The CORESET#0 Index and the associated CORESET#0 Offset refers to Table 13-8 in TS 38.213 [22]. The value of CORESET#0 Index is signalled in controlResourceSetZero (pdch-ConfigSIB1) in the MIB. The offsetToPointA IE is expressed in units of resource blocks assuming 15 kHz subcarrier spacing for FR1 and 60 kHz subcarrier spacing for FR2.</p> <p>Note 2: The parameter Offset Carrier CORESET#0 specifies the offset from the lowest subcarrier of the carrier and the lowest subcarrier of CORESET#0. It corresponds to the parameter <math>\Delta F_{\text{OffsetCORESET-0-Carrier}}</math> in Annex C expressed in number of common RBs.</p>															

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The DL and UL Reference Measurement channels are set according to Table 6.2.3.4.1-2 to Table 6.2.3.4.1-3.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.2.3.4.3

#### 6.2.3.4.2 Test procedure

1. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.2.3.4.1-2 to Table 6.2.3.4.1-3. Since the UL has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC.
2. Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
3. Send continuously uplink power control "up" commands in every uplink scheduling information to the UE; allow at least 200 msec starting from the first TPC command in this step to ensure that the UE transmits at its maximum output power. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
4. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
5. Measure UE EIRP in the Tx beam peak direction in the channel bandwidth of the radio access mode according to the test configuration, which shall meet the requirements described in Table 6.2.3.5-4 to Table 6.2.3.5-12. EIRP test procedure is defined in Annex K. The measuring duration is one active uplink subframe. EIRP is calculated considering both polarizations, theta and phi.
6. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

#### 6.2.3.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6, with the following exceptions for each network signalling value.

1. Information element *AdditionalSpectrumEmission* for NR can be set in SIB1 according to TS 38.331[19]. This exception indicates that the UE shall meet the additional spurious emission requirement for a specific deployment scenario.

**Table 6.2.3.4.3-1: *AdditionalSpectrumEmission*: Additional spurious emissions test requirement**

Derivation Path: TS 38.508-1 [10] clause 4.6.3, Table 4.6.3-1			
Information Element	Value/remark	Comment	Condition
<i>AdditionalSpectrumEmission</i>	1 (NS_202)	for band n257	
<i>AdditionalSpectrumEmission</i>	2 (NS_202)	for band n258	
<i>AdditionalSpectrumEmission</i>	3 (NS_203)	for band n258	

#### 6.2.3.5 Test requirement

The UE EIRP derived in step 5 shall not exceed the values specified in Table 6.2.3.5-5 to Table 6.2.3.5-13.

Table 6.2.3.5-1: Void

Table 6.2.3.5-2: Void

Table 6.2.3.5-3: Void

Table 6.2.3.5-4: Void

Table 6.2.3.5-5: UE Power Class 1 test requirements (network signalling value "NS\_202")

Band	Test ID	P <sub>Powerclass</sub>	MPR <sub>f,c</sub>	A- MPR <sub>f,c</sub>	T(MAX(MPR <sub>f,c</sub> , A-MPR <sub>f,c</sub> ))	Lower limit (dBm)	Upper limit (dBm)
n257, n258	2	40	0	11	7	22-TT	55
	3		6.5	11	7	22-TT	55

Table 6.2.3.5-6: UE Power Class 2 test requirements (network signalling value "NS\_202")

Band	Test ID	P <sub>Powerclass</sub>	MPR <sub>f,c</sub>	A- MPR <sub>f,c</sub>	T(MAX(MPR <sub>f,c</sub> , A-MPR <sub>f,c</sub> ))	Lower limit (dBm)	Upper limit (dBm)
n257, n258	1	29	0	1	1.5	26.5-TT	43
	2		0	1	1.5	26.5-TT	43

Table 6.2.3.5-7: UE Power Class 3 test requirements (network signalling value "NS\_202")

Band	Test ID	P <sub>Powerclass</sub>	MPR <sub>f,c</sub>	A- MPR <sub>f,c</sub>	T(MAX(MPR <sub>f,c</sub> , A-MPR <sub>f,c</sub> ))	Lower limit (dBm)	Upper limit (dBm)
n257, n258	1	22.4	0	1	1.5	19.2-TT- $\Delta$ MB <sub>P,n</sub>	43
	2		0	1	1.5	19.2-TT- $\Delta$ MB <sub>P,n</sub>	43

Note 1:  $\Delta$ MB<sub>P,n</sub> is the Multiband Relaxation factor for the tested band. This shall fulfil the requirements in Table 6.2.1.1.3.3-5.

Table 6.2.3.5-8: UE Power Class 4 test requirements (network signalling value "NS\_202")

Band	Test ID	P <sub>Powerclass</sub>	MPR <sub>f,c</sub>	A- MPR <sub>f,c</sub>	T(MAX(MPR <sub>f,c</sub> , A-MPR <sub>f,c</sub> ))	Lower limit (dBm)	Upper limit (dBm)
n257, n258	1	34	0	1	1.5	31.5-TT	43
	2		0	1	1.5	31.5-TT	43

Table 6.2.3.5-9: UE Power Class 1 test requirements (network signalling value "NS\_203")

Band	Test ID	P <sub>Powerclass</sub>	MPR <sub>f,c</sub>	A- MPR <sub>f,c</sub>	T(MAX(MPR <sub>f,c</sub> , A-MPR <sub>f,c</sub> ))	Lower limit (dBm)	Upper limit (dBm)
n258	1	40	0	3	2	35-TT	55
	2		0	3	2	35-TT	55
	3		0	0	0	40-TT	55

Table 6.2.3.5-10: UE Power Class 2 test requirements (network signalling value "NS\_203")

Band	Test ID	P <sub>Powerclass</sub>	MPR <sub>f,c</sub>	A- MPR <sub>f,c</sub>	T(MAX(MPR <sub>f,c</sub> , A-MPR <sub>f,c</sub> ))	Lower limit (dBm)	Upper limit (dBm)
n258	1	29	0	0	0	29-TT	43
	2		0	0	0	29-TT	43

Table 6.2.3.5-11: UE Power Class 3 test requirements (network signalling value "NS\_203")

Band	Test ID	P <sub>Powerclass</sub>	MPR <sub>f,c</sub>	A- MPR <sub>f,c</sub>	T(MAX(MPR <sub>f,c</sub> , A-MPR <sub>f,c</sub> ))	Lower limit (dBm)	Upper limit (dBm)
n258	1	22.4	0	0	0	22.4-TT- $\Delta$ MB <sub>P,n</sub>	43
	2		0	0	0	22.4-TT- $\Delta$ MB <sub>P,n</sub>	43

Note 1:  $\Delta$ MB<sub>P,n</sub> is the Multiband Relaxation factor for the tested band. This shall fulfil the requirements in Table 6.2.1.1.3.3-5.

Table 6.2.3.5-12: UE Power Class 4 test requirements (network signalling value "NS\_203")

Band	Test ID	P <sub>Powerclass</sub>	MPR <sub>f,c</sub>	A- MPR <sub>f,c</sub>	T(MAX(MPR <sub>f,c</sub> , A-MPR <sub>f,c</sub> ))	Lower limit (dBm)	Upper limit (dBm)
n258	1	34	0	0	0	34-TT	43
	2		0	0	0	34-TT	43

Table 6.2.3.5-13: Test Tolerance (Power class 3)

Test Metric	FR2a	FR2b
Max device size $\leq$ 30 cm	3.11 dB	3.11 dB

## 6.2.4 Configured transmitted power

### 6.2.4.1 Test purpose

To verify the UE configured transmitted power  $P_{UMAX,f,c}$  is within the range defined prescribed by the specified nominal maximum output power and tolerance.

### 6.2.4.2 Test applicability

The requirements of this test are covered in test cases 6.2.1 Maximum output power, 6.2.2 Maximum output power reduction and 6.2.3 UE maximum output power with additional requirements to all types of NR UE release 15 and forward.

### 6.2.4.3 Minimum conformance requirements

The UE can configure its maximum output power. The configured UE maximum output power  $P_{CMAX,f,c}$  for carrier  $f$  of a serving cell  $c$  is defined as that available to the reference point of a given transmitter branch that corresponds to the reference point of the higher-layer filtered RSRP measurement as specified in TS 38.215 [24].

The configured UE maximum output power  $P_{CMAX,f,c}$  for carrier  $f$  of a serving cell  $c$  shall be set such that the corresponding measured peak EIRP  $P_{UMAX,f,c}$  is within the following bounds

$$P_{Powerclass} + \Delta P_{IBE} - \text{MAX}(\text{MAX}(MPR_{f,c}, A-MPR_{f,c}), \Delta MB_{P,n}, P-MPR_{f,c}) - \text{MAX}\{T(\text{MAX}(MPR_{f,c}, A-MPR_{f,c})), T(P-MPR_{f,c})\} \leq P_{UMAX,f,c} \leq EIRP_{max}$$

while the corresponding measured total radiated power  $P_{TMAX,f,c}$  is bounded by

$$P_{TMAX,f,c} \leq TRP_{max}$$

with  $P_{Powerclass}$  the UE minimum peak EIRP as specified in sub-clause 6.2.1.1.3,  $EIRP_{max}$  the applicable maximum EIRP as specified in sub-clause 6.2.1.1.3,  $MPR_{f,c}$  as specified in sub-clause 6.2.2.3,  $A-MPR_{f,c}$  as specified in sub-clause 6.2.3.3,  $\Delta MB_{P,n}$  the peak EIRP relaxation as specified in section 6.2.1.1.3 and  $TRP_{max}$  the maximum TRP for the UE power class as specified in sub-clause 6.2.1.1.3.  $\Delta P_{IBE}$  is 1.0 dB if UE declares support for *mpr-PowerBoost-FR2-r16*, UL transmission is QPSK,  $MPR_{f,c} = 0$  and when NS\_200 applies and the network configures the UE to operate with *mpr-PowerBoost-FR2-r16*, otherwise  $\Delta P_{IBE}$  is 0.0 dB. The requirement is verified in beam peak direction.

*maxUplinkDutyCycle-FR2* as defined in TS 38.306 [26] is a UE capability to facilitate electromagnetic power density exposure requirements. This UE capability is applicable to all FR2 power classes.

If the field of UE capability *maxUplinkDutyCycle-FR2* is present and the percentage of uplink symbols transmitted within any 1 s evaluation period is larger than *maxUplinkDutyCycle-FR2*, the UE follows the uplink scheduling and can apply  $P-MPR_{f,c}$ .

If the field of UE capability *maxUplinkDutyCycle-FR2* is absent, the compliance to electromagnetic power density exposure requirements are ensured by means of scaling down the power density or by other means.

$P-MPR_{f,c}$  is the power management maximum output power reduction. The UE shall apply  $P-MPR_{f,c}$  for carrier  $f$  of serving cell  $c$  only for the cases described below. For UE conformance testing  $P-MPR_{f,c}$  shall be 0 dB.

- a) ensuring compliance with applicable electromagnetic power density exposure requirements and addressing unwanted emissions / self desense requirements in case of simultaneous transmissions on multiple RAT(s) for scenarios not in scope of 3GPP RAN specifications;
- b) ensuring compliance with applicable electromagnetic power density exposure requirements in case of proximity detection is used to address such requirements that require a lower maximum output power.

NOTE 1:  $P-MPR_{f,c}$  was introduced in the  $P_{CMAX,f,c}$  equation such that the UE can report to the gNB the available maximum output transmit power. This information can be used by the gNB for scheduling decisions.

NOTE 2:  $P-MPR_{f,c}$  and *maxUplinkDutyCycle-FR2* may impact the maximum uplink performance for the selected UL transmission path.

NOTE 3: MPE  $P-MPR$  Reporting, as defined in TS 38.306 [26], is an optional UE capability to report  $P-MPR_{f,c}$  when the reporting conditions configured by gNB are met. This UE capability is applicable to all FR2 power classes.

The tolerance  $T(\Delta P)$  for applicable values of  $\Delta P$  (values in dB) is specified in Table 6.2.4.3-1.

**Table 6.2.4.3-1:  $P_{UMAX,f,c}$  tolerance**

Operating Band	$\Delta P$ (dB)	Tolerance $T(\Delta P)$ (dB)
n257, n258, n259, n260, n261	$\Delta P = 0$	0
	$0 < \Delta P \leq 2$	1.5
	$2 < \Delta P \leq 3$	2.0
	$3 < \Delta P \leq 4$	3.0
	$4 < \Delta P \leq 5$	4.0
	$5 < \Delta P \leq 10$	5.0
	$10 < \Delta P \leq 15$	7.0
	$15 < \Delta P \leq X$	8.0
NOTE: X is the value such that $P_{umax,f,c}$ lower bound, $P_{Powerclass} - \Delta P - T(\Delta P) =$ minimum output power specified in clause 6.3.1.		

#### 6.2.4.4 Test description

This test is covered by clause 6.2.1 Maximum output power, 6.2.2 Maximum output power reduction and 6.2.3 UE maximum output power with additional requirements.

#### 6.2.4.5 Test requirements

This test is covered by clause 6.2.1 Maximum output power, 6.2.2 Maximum output power reduction and 6.2.3 UE maximum output power with additional requirements.

### 6.2.4\_1 Configured transmitted power with Power Boost

**Editor's note: The following aspects are either missing or not yet determined:**

- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.
- The test case is incomplete for band n259.

#### 6.2.4\_1.1 Test purpose

To verify the UE configured transmitted power  $P_{UMAX,f,c}$  is within the range defined prescribed by the specified nominal maximum output power and tolerance.

#### 6.2.4\_1.2 Test applicability

This test case applies to all types of NR UE release 16 and forward supporting *mpr-PowerBoost-FR2-r16* UE capability.

#### 6.2.4\_1.3 Minimum conformance requirements

Same as clause 6.2.4.3.

#### 6.2.4\_1.4 Test description

##### 6.2.4\_1.4.1 Initial conditions

Same as clause 6.2.1.1.4.1

6.2.4\_1.4.2 Test procedure

1. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.2.1.1.4.1-1. Since the UL has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC. Messages to configure the appropriate uplink modulation in section 6.2.4\_1.4.3.
2. Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
3. Send continuously uplink power control "up" commands in every uplink scheduling information to the UE; allow at least 200 msec starting from the first TPC command in this step to ensure that the UE transmits at its maximum output power. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
4. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
5. Measure UE EIRP in the Tx beam peak direction in the channel bandwidth of the radio access mode according to the test configuration, which shall meet the requirements described in Tables 6.2.4\_1.5-1 to 6.2.4\_1.5-4. EIRP test procedure is defined in Annex K.1.3. The measuring duration is one active uplink subframe. EIRP is calculated considering both polarizations, theta and phi.
6. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

6.2.4\_1.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with TRANSFORM\_PRECODER\_ENABLED condition in Table 4.6.3-118 PUSCH-Config with the following exceptions:

**Table 6.2.4\_1.4.3-1: ServinCellConfig**

Derivation Path: TS 38.508-1 [5], Table 4.6.3-167			
Information Element	Value/remark	Comment	Condition
ServingCellConfig ::= SEQUENCE {			
uplinkConfig SEQUENCE {			
mpr-PowerBoost-FR2-r16	True		
}			
}			

6.2.4\_1.5 Test requirement

The EIRP derived in step 5 shall not exceed the values specified in Table 6.2.4\_1.5-1 to Table 6.2.4\_1.5-4.

**Table 6.2.4\_1.5-1: UE maximum output test requirements for power class 1**

Operating band	Max EIRP (dBm)	Min peak EIRP (dBm)
n257	55	41.0-TT
n258	55	41.0-TT
n260	55	39.0-TT
n261	55	41.0-TT

**Table 6.2.4\_1.5-2: UE maximum output test requirements for power class 2**

Operating band	Max EIRP (dBm)	Min peak EIRP (dBm)
n257	43	30-TT
n258	43	30-TT
n260		
n261	43	30-TT

**Table 6.2.4\_1.5-3: UE maximum output test requirements for power class 3 for single band UE**

Operating band	Max EIRP (dBm)	Min peak EIRP (dBm)
n257	43	23.4-TT
n258	43	23.4-TT
n260	43	21.6-TT
n261	43	23.4-TT

**Table 6.2.4\_1.5-3a: Test Tolerance (Min peak EIRP for Power class 3)**

Test Metric	FR2a	FR2b
Max device size $\leq$ 30 cm	2.87 dB (NTC) 3.04 (ETC)	2.87 dB (NTC) 3.04 (ETC)

**Table 6.2.4\_1.5-3b: UE maximum output test requirements for power class 3**

ID	FR2 bands/set	Test requirement (dB) (Note 1)					Comments
		n257	n258	n259	n260	n261	
1	n257	23.4-TT- $\Delta$ MB <sub>P,n</sub>					
2	n258		23.4-TT- $\Delta$ MB <sub>P,n</sub>				
3	n259			19.7-TT- $\Delta$ MB <sub>P,n</sub>			
4	n260				21.6-TT- $\Delta$ MB <sub>P,n</sub>		
5	n261					23.4-TT- $\Delta$ MB <sub>P,n</sub>	
6	n257, n261	23.4-TT- $\Delta$ MB <sub>P,n</sub>				23.4-TT- $\Delta$ MB <sub>P,n</sub>	$\Delta$ MB <sub>P,n</sub> relaxation is 0 dB
7	n260, n261				21.6-TT- $\Delta$ MB <sub>P,n</sub>	23.4-TT- $\Delta$ MB <sub>P,n</sub>	$\Delta$ MB <sub>P,n</sub> relaxation is 0 dB

Note 1:  $\Delta$ MB<sub>P,n</sub> is the Multi-band Relaxation factor for the tested band. This shall fulfil the requirements in Table 6.2.1.1.3.3-5.

**Table 6.2.4\_1.5-4: UE maximum output power test requirements for power class 4**

Operating band	Max EIRP (dBm)	Min peak EIRP (dBm)
n257	43	35-TT
n258	43	35-TT
n260	43	35-TT
n261	43	35-TT

## 6.2A Transmit power for CA

### 6.2A.1 UE maximum output power for CA

#### 6.2A.1.0 Minimum conformance requirements

For downlink intra-band contiguous and non-contiguous carrier aggregation with a single uplink component carrier configured in the NR band, the maximum output power is specified in subclause 6.2.1.1.3.

For uplink intra-band contiguous carrier aggregation for any CA bandwidth class, the maximum output power is specified in subclause 6.2.1.1.3.



Power class 3 is default power class.

## 6.2A.1.1 UE maximum output power - EIRP and TRP for CA

### 6.2A.1.1.1 UE maximum output power - EIRP and TRP for CA (2UL CA)

**Editor's note:** The following aspects are either missing or not yet determined:

- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 400MHz is TBD.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.
- Test Procedures for EIRP beam peak Extreme Conditions are FFS.

#### 6.2A.1.1.1.1 Test purpose

To verify that the power of any UE emission shall not exceed specified level for the specified channel bandwidth for CA under the deployment scenarios where additional requirements are specified.

#### 6.2A.1.1.1.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 2UL CA.

#### 6.2A.1.1.1.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.2A.1.0.

#### 6.2A.1.1.1.4 Test description

##### 6.2A.1.1.1.4.1 Initial condition

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, and channel bandwidths based on NR operating bands specified in clause 5.5A. All of these configurations shall be tested with applicable test parameters for each channel bandwidth and subcarrier spacing, are shown in Table 6.2A.1.1.1.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.2A.1.1.1.4.1-1: Intra-band Contiguous CA Test Configuration Table**

Default Conditions					
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal, TL, TH (NOTE 2)		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes			Low and High range		
Test CC Combination setting (aggregated BW of the CA configuration) as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE			Highest aggregated BW of the CA configuration ( $\leq 400$ MHz aggregated channel bandwidth)		
Test SCS as specified in Table 5.3.5-1			120 kHz		
Test Parameters					
CA Configuration / Aggregated BW			Downlink Configuration	Uplink Configuration	
Test ID	CC & Mapping (NOTE 4)	CBW (MHz)	RB allocation	Modulation	RB allocation (NOTE 1)
1	PCC/CC1	100	-	DFT-s-OFDM QPSK	Inner Full for PC2, PC3 and PC4 Inner_Full_Region1 for PC1
	SCC/CC2	100		-	-
2	PCC/CC1	200		DFT-s-OFDM QPSK	Inner Full for PC2, PC3 and PC4

				Inner_Full_Region1 for PC1
	SCC/CC2	200	-	-
NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.				
NOTE 2: Test environment for UE Max TRP is normal only.				
NOTE 3: CA Configuration Test cumulative aggregated BW settings are checked separately for each CA Configuration, which applicable aggregated channel bandwidths are specified in Table 5.5A.1-1.				
NOTE 4: PCC/CCi and SCC/CCj means PCC is on component carrier CCi and SCC is on component carrier CCj, with CCi or CCj frequencies defined in TS38.508-1 [10].				
NOTE 5: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: <i>"The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier"</i> .				

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement channels are set according to Table 6.2A.1.1.1.4.1-1.
5. Propagation conditions are set according to Annex B.0
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity NR, Connected without release On, Test Mode On and Test Loop Function On according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.2A.1.1.1.4.3

#### 6.2A.1.1.1.4.2 Test procedure

1. Configure SCC according to Annex C.0, C.1, C.2 for all downlink physical channels.
2. The SS shall configure SCC as per TS 38.508-1 [10] subclause 5.5.1. Message contents are defined in clause 6.2A.1.1.1.4.3.
3. SS activates SCC by sending the activation MAC CE (Refer TS 38.321 [28], clauses 5.9, 6.1.3.10). Wait for at least 2 seconds (Refer TS 38.133[25], clause 9.3).
4. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.2A.1.1.1.4.1-1. Since the UL has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC. Messages to configure the appropriate uplink modulation in section 6.2A.1.1.1.4.3.
5. Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
6. Send continuously uplink power control "up" commands in every uplink scheduling information to the UE; allow at least 200 msec starting from the first TPC command in this step to ensure that the UE transmits at its maximum output power. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
7. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
8. Measure UE EIRP in the Tx beam peak direction in the channel bandwidth of the radio access mode according to the test configuration, which shall meet the requirements described in Table 6.2A.1.1.1.5-1. EIRP test procedure is defined in Annex K.1.3. The measuring duration is one active uplink subframe. EIRP is calculated considering both polarizations, theta and phi.
9. Measure TRP of the transmitted signal for the assigned NR channel with a rectangular measurement filter with bandwidths according to Table 6.2A.1.1.1.5-1. Total radiated power is measured according to TRP measurement procedure defined in Annex K.1.7 and measurement grid specified in Annex M.4. TRP is calculated considering both polarizations, theta and phi.

10. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

#### 6.2A.1.1.1.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with TRANSFORM\_PRECODER\_ENABLED condition in Table 4.6.3-118 PUSCH-Config.

#### 6.2A.1.1.1.5 Test Requirements

The EIRP derived in step 8 and TRP derived in step 9 shall not exceed the values specified in Table 6.2A.1.1.1.5-1 to Table 6.2A.1.1.1.5-4.

**Table 6.2A.1.1.1.5-1: Intra-band Contiguous CA UE maximum output test requirements for power class 1**

UL CA configuration	Max TRP (dBm)	Max EIRP (dBm)	Min peak EIRP (dBm)
CA_n257D	35+TT	55	40-TT
CA_n257G	35+TT	55	40-TT
CA_n260D	35+TT	55	38-TT
CA_n260G	35+TT	55	38-TT
CA_n260O	35+TT	55	38-TT
CA_n261D	35+TT	55	40-TT
CA_n261G	35+TT	55	40-TT
CA_n261O	35+TT	55	40-TT

**Table 6.2A.1.1.1.5-2: Intra-band Contiguous CA UE maximum output test requirements for power class 2**

UL CA configuration	Max TRP (dBm)	Max EIRP (dBm)	Min peak EIRP (dBm)
CA_n257D	23+TT	43	29-TT
CA_n257G	23+TT	43	29-TT
CA_n261D	23+TT	43	29-TT
CA_n261G	23+TT	43	29-TT
CA_n261O	23+TT	43	29-TT

**Table 6.2A.1.1.1.5-3: Intra-band Contiguous CA UE maximum output test requirements for power class 3**

UL CA configuration	Max TRP (dBm)	Max EIRP (dBm)	Min peak EIRP (dBm)
CA_n257D	23+TT	43	22.4-TT
CA_n257G	23+TT	43	22.4-TT
CA_n260D	23+TT	43	20.6-TT
CA_n260G	23+TT	43	20.6-TT
CA_n260O	23+TT	43	20.6-TT
CA_n261D	23+TT	43	22.4-TT
CA_n261G	23+TT	43	22.4-TT
CA_n261O	23+TT	43	22.4-TT

**Table 6.2A.1.1.1.5-3a: UE maximum output test requirements for power class 3 for multi band UE declaring MB<sub>p</sub>>0 in any FR2 band**

ID	Supported FR2 bands set	Test requirement (dB) (Note 1)				Maximum sum of MB <sub>p</sub> , ∑MB <sub>p</sub> (dB) (Note 3)	Comments
		CA_n257D/G	CA_n258	CA_n260D/G/ O	CA_n261D/G/ O		
1	n257, n258	22.4-TT-MB <sub>p</sub>				1.3	

2	n257, n260	22.4-TT-MB <sub>p</sub>		20.6-TT-MB <sub>p</sub>		1.0	
3	n258, n260			20.6-TT-MB <sub>p</sub>		1.0	
4	n258, n261				22.4-TT-MB <sub>p</sub>	1.0	
5	n260, n261					0.0	No relaxation factor allowed
6	n257, n258, n260	22.4-TT-MB <sub>p</sub>		20.6-TT-MB <sub>p</sub>		1.7	
7	n257, n258, n261	22.4-TT-MB <sub>p</sub>			22.4-TT-MB <sub>p</sub>	1.7	
8	n257, n260, n261	22.4-TT-MB <sub>p</sub>		20.6-TT-MB <sub>p</sub>	22.4-TT-MB <sub>p</sub>	0.5	
9	n258, n260, n261			20.6-TT-MB <sub>p</sub>	22.4-TT-MB <sub>p</sub>	1.5	
10	n257, n258, n260, n261	22.4-TT-MB <sub>p</sub>		20.6-TT-MB <sub>p</sub>	22.4-TT-MB <sub>p</sub>	1.7	

Note 1: MB<sub>p</sub> is the Multiband Relaxation factor declared by the UE for the tested band in Table A.4.3.9-2 of TS38.508-2. This declaration shall fulfil the requirements in clause 6.2.1.1.3.3.

Note 2: All UE supported bands needs to be tested to ensure the multiband relaxation declaration is compliant

Note 3: Max allowed sum of MB<sub>p</sub> over all supported FR2 bands as defined in clause 6.2.1.1.3.3

**Table 6.2A.1.1.1.5-3b: Test Tolerance (Max TRP for Power class 3) (Aggregated BW ≤ 400MHz)**

Test Metric	FR2a	FR2b
Max device size ≤ 30 cm	2.65 dB	2.77 dB

**Table 6.2A.1.1.1.5-3c: Test Tolerance (Min peak EIRP for Power class 3) (Aggregated BW ≤ 400MHz)**

Test Metric	FR2a	FR2b
Max device size ≤ 30cm	2.87 dB	2.87 dB

**Table 6.2A.1.1.1.5-4: Intra-band Contiguous CA UE maximum output test requirements for power class 4**

UL CA configuration	Max TRP (dBm)	Max EIRP (dBm)	Min peak EIRP (dBm)
CA_n257D	23+TT	43	34-TT
CA_n257G	23+TT	43	34-TT
CA_n260B	23+TT	43	31-TT
CA_n260D	23+TT	43	31-TT
CA_n260G	23+TT	43	31-TT
CA_n260O	23+TT	43	31-TT
CA_n261B	23+TT	43	34-TT
CA_n261D	23+TT	43	34-TT
CA_n261G	23+TT	43	34-TT
CA_n261O	23+TT	43	34-TT

**6.2A.1.1.2 UE maximum output power - EIRP and TRP for CA (3UL CA)**

Editor's note: The following aspects are either missing or not yet determined:

- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 400MHz is TBD.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.
- Test Procedures for EIRP beam peak Extreme Conditions are FFS.

**6.2A.1.1.2.1 Test purpose**

To verify that the power of any UE emission shall not exceed specified level for the specified channel bandwidth for CA under the deployment scenarios where additional requirements are specified.

**6.2A.1.1.2.2 Test applicability**

This test case applies to all types of NR UE release 15 and forward that supports FR2 3UL CA.

## 6.2A.1.1.2.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.2A.1.0.

## 6.2A.1.1.2.4 Test description

Same as in clause 6.2A.1.1.1.4 with following exceptions:

- Instead of Table 6.2A.1.1.1.4.1-1 → use Table 6.2A.1.1.2.4-1.
- Instead of Table 6.2A.1.1.1.5-1 → use Table 6.2A.1.1.2.5-1.

**Table 6.2A.1.1.2.4-1: Test Configuration Table**

Default Conditions					
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal, TL, TH (NOTE 2)		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes			Low and High range		
Test CC Combination setting (aggregated BW of the CA configuration) as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE			Highest aggregated BW ( $\leq 400$ MHz aggregated channel bandwidth)		
Test SCS as specified in Table 5.3.5-1			120 kHz		
Test Parameters					
CA Configuration / Aggregated BW			Downlink Configuration	Uplink Configuration	
Test ID	CC & Mapping (NOTE 4)	CBW (MHz)	RB allocation	Modulation	RB allocation (NOTE 1)
1	PCC/CC1	100	-	DFT-s-OFDM QPSK	Inner Full for PC2, PC3 and PC4 Inner_Full_Region1 for PC1
	SCC/CC2	100		-	-
	SCC/CC3	100		-	-
NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.					
NOTE 2: Test environment for UE Max TRP is normal only.					
NOTE 3: CA Configuration Test cumulative aggregated BW settings are checked separately for each CA Configuration, which applicable aggregated channel bandwidths are specified in Table 5.5A.1-1.					
NOTE 4: If the UE supports multiple CC Combinations in the CA Configuration with the same cumulative aggregated BW, only the combination with the lowest PCC ChBW is tested.					
NOTE 5: PCC/CC <sub>i</sub> and SCC/CC <sub>j</sub> means PCC is on component carrier CC <sub>i</sub> and SCC is on component carrier CC <sub>j</sub> , with CC <sub>i</sub> or CC <sub>j</sub> frequencies defined in TS38.508-1 [10].					
NOTE 6: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".					

## 6.2A.1.1.2.5 Test Requirements

The EIRP derived in step 8 and TRP derived in step 9 shall not exceed the values specified in Table 6.2A.1.1.2.5-1.

**Table 6.2A.1.1.2.5-1: UE maximum output test requirements for power class 3**

CA configuration	Max TRP (dBm)	Max EIRP (dBm)	Min peak EIRP (dBm)
CA_n257H	23+TT	43	22.4-TT
CA_n260H	23+TT	43	20.6-TT

**Table 6.2A.1.1.2.5-1a: Test Tolerance (Max TRP for Power class 3) (Aggregated BW  $\leq 400$ MHz)**

Test Metric	FR2a	FR2b
Max device size $\leq 30$ cm	2.65 dB	2.77 dB

**Table 6.2A.1.1.2.5-1b: Test Tolerance (Min peak EIRP for Power class 3) (Aggregated BW ≤ 400MHz)**

Test Metric	FR2a	FR2b
Max device size ≤ 30 cm	2.87 dB	2.87 dB

**6.2A.1.1.3 UE maximum output power - EIRP and TRP for CA (4UL CA)**

Editor's note: The following aspects are either missing or not yet determined:

- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 400MHz is TBD.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.
- Test Procedures for EIRP beam peak Extreme Conditions are FFS.

**6.2A.1.1.3.1 Test purpose**

To verify that the power of any UE emission shall not exceed specified level for the specified channel bandwidth for CA under the deployment scenarios where additional requirements are specified.

**6.2A.1.1.3.2 Test applicability**

This test case applies to all types of NR UE release 15 and forward that supports FR2 4UL CA.

**6.2A.1.1.3.3 Minimum conformance requirements**

The minimum conformance requirements are defined in clause 6.2A.1.0.

**6.2A.1.1.3.4 Test description**

Same as in clause 6.2A.1.1.1.4 with following exceptions:

- Instead of Table 6.2A.1.1.1.4.1-1 → use Table 6.2A.1.1.3.4-1.
- Instead of Table 6.2A.1.1.1.5-1 → use Table 6.2A.1.1.3.5-1.

**Table 6.2A.1.1.3.4-1: Test Configuration Table**

Default Conditions					
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal, TL, TH (NOTE 2)		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes, and PCC and SCC are mapped onto physical frequencies according to Table 6.1-2			Low and High range		
Test CC Combination setting (cumulative aggregated BW of the CA configuration) as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE			Highest aggregated BW (≤ 400 MHz aggregated channel bandwidth)		
Test SCS as specified in Table 5.3.5-1			120 kHz		
Test Parameters					
CA Configuration / Aggregated BW			Downlink Configuration		Uplink Configuration
Test ID	CC & Mapping (NOTE 4)	ChBw	RB allocation	Modulation	RB allocation (NOTE 1)
1	PCC/CC1	100	-	DFT-s-OFDM QPSK	Inner Full for PC2, PC3 and PC4 Inner_Full_Region1 for PC1
	SCC/CC2	100	-	-	-
	SCC/CC3	100	-	-	-

	SCC/CC4	100	-	-
NOTE 1:	The specific configuration of each RF allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.			
NOTE 2:	Test environment for UE Max TRP is normal only.			
NOTE 3:	CA Configuration Test cumulative aggregated BW settings are checked separately for each CA Configuration, which applicable aggregated channel bandwidths are specified in Table 5.5A.1-1.			
NOTE 4:	If the UE supports multiple CC Combinations in the CA Configuration with the same cumulative aggregated BW, only the combination with the lowest PCC ChBW is tested.			
NOTE 5:	PCC/CCi and SCC/CCj means PCC is on component carrier CCi and SCC is on component carrier CCj, with CCi or CCj frequencies defined in TS38.508-1 [10].			
NOTE 6:	Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".			

#### 6.2A.1.1.3.5 Test Requirements

The EIRP derived in step 8 and TRP derived in step 9 shall not exceed the values specified in Table 6.2A.1.1.3.5-1.

**Table 6.2A.1.1.3.5-1: UE maximum output test requirements for power class 3**

CA configuration	Max TRP (dBm)	Max EIRP (dBm)	Min peak EIRP (dBm)
CA_n257I	23+TT	43	22.4-TT
CA_n260I	23+TT	43	20.6-TT

**Table 6.2A.1.1.3.5-1a: Test Tolerance (Max TRP for Power class 3) (Aggregated BW ≤ 400MHz)**

Test Metric	FR2a	FR2b
Max device size ≤ 30 cm	2.65 dB	2.77 dB

**Table 6.2A.1.1.3.5-1b: Test Tolerance (Min peak EIRP for Power class 3) (Aggregated BW ≤ 400MHz)**

Test Metric	FR2a	FR2b
Max device size ≤ 30 cm	2.87 dB	2.87 dB

#### 6.2A.1.1.4 UE maximum output power - EIRP and TRP for CA (5UL CA)

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- No test points are defined since there is no configuration satisfying MPR=0dB requirements in RAN4.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2, 3 and 4.
- Test Procedures for EIRP beam peak Extreme Conditions are FFS.
- Test Tolerances in the Test Requirement are FFS.

##### 6.2A.1.1.4.1 Test purpose

To verify that the error of the UE maximum output power does not exceed the range prescribed by the specified nominal maximum output power and tolerance.

An excess maximum output power has the possibility to interfere to other channels or other systems. A small maximum output power decreases the coverage area.

##### 6.2A.1.1.4.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 5UL CA.

NOTE: This test case can't be performed due to lack of appropriate test points.

## 6.2A.1.1.4.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.2A.1.0.

## 6.2A.1.1.4.4 Test description

Same as in clause 6.2A.1.1.4 with following exceptions:

- Instead of Table 6.2A.1.1.4.1-1 → use Table 6.2A.1.1.4.4-1.
- Instead of Table 6.2A.1.1.4.5-1 → use Table 6.2A.1.1.4.5-1.

**Table 6.2A.1.1.4.4-1: Test Configuration Table**

NOTE: No test points are defined since there is no configuration satisfying MPR=0dB requirements in RAN4.

## 6.2A.1.1.4.5 Test Requirements

The EIRP derived in step 8 and TRP derived in step 9 shall not exceed the values specified in Table 6.2A.1.1.4.5-1.

**Table 6.2A.1.1.4.5-1: UE maximum output test requirements for power class 3**

CA configuration	Max TRP (dBm)	Max EIRP (dBm)	Min peak EIRP (dBm)
CA_n257J	23+TT	43	22.4-TT

**Table 6.2A.1.1.4.5-1a: Test Tolerance (Max TRP for Power class 3)**

Test Metric	FR2a	FR2b
Max device size ≤ 30 cm	TBD	TBD

**Table 6.2A.1.1.4.5-1b: Test Tolerance (Min peak EIRP for Power class 3)**

Test Metric	FR2a	FR2b
Max device size ≤ 30 cm	TBD	TBD

## 6.2A.1.1.5 UE maximum output power - EIRP and TRP for CA (6UL CA)

Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:

- No test points are defined since there is no configuration satisfying MPR=0dB requirements in RAN4.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2, 3 and 4.
- Test Procedures for EIRP beam peak Extreme Conditions are FFS.
- Test Tolerances in the Test Requirement are FFS.

## 6.2A.1.1.5.1 Test purpose

To verify that the error of the UE maximum output power does not exceed the range prescribed by the specified nominal maximum output power and tolerance.

An excess maximum output power has the possibility to interfere to other channels or other systems. A small maximum output power decreases the coverage area.

## 6.2A.1.1.5.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 6UL CA.

NOTE: This test case can't be performed due to lack of appropriate test points.



## 6.2A.1.1.5.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.2A.1.0.

## 6.2A.1.1.5.4 Test description

Same as in clause 6.2A.1.1.4 with following exceptions:

- Instead of Table 6.2A.1.1.4.1-1 → use Table 6.2A.1.1.5.4-1.
- Instead of Table 6.2A.1.1.5-1 → use Table 6.2A.1.1.5.5-1.

**Table 6.2A.1.1.5.4-1: Test Configuration Table**

NOTE: No test points are defined since there is no configuration satisfying MPR=0dB requirements in RAN4.

## 6.2A.1.1.5.5 Test Requirements

The EIRP derived in step 8 and TRP derived in step 9 shall not exceed the values specified in Table 6.2A.1.1.5.5-1.

**Table 6.2A.1.1.5.5-1: UE maximum output test requirements for power class 3**

CA configuration	Max TRP (dBm)	Max EIRP (dBm)	Min peak EIRP (dBm)
CA_n257K	23+TT	43	22.4-TT
CA_n260K	23+TT	43	20.6-TT
CA_n261K	23+TT	43	22.4-TT

**Table 6.2A.1.1.5.5-1a: Test Tolerance (Max TRP for Power class 3)**

Test Metric	FR2a	FR2b
Max device size ≤ 30 cm	TBD	TBD

**Table 6.2A.1.1.5.5-1b: Test Tolerance (Min peak EIRP for Power class 3)**

Test Metric	FR2a	FR2b
Max device size ≤ 30 cm	TBD	TBD

## 6.2A.1.1.6 UE maximum output power - EIRP and TRP for CA (7UL CA)

Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:

- No test points are defined since there is no configuration satisfying MPR=0dB requirements in RAN4.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2, 3 and 4.
- Test Procedures for EIRP beam peak Extreme Conditions are FFS.
- Test Tolerances in the Test Requirement are FFS.

## 6.2A.1.1.6.1 Test purpose

To verify that the error of the UE maximum output power does not exceed the range prescribed by the specified nominal maximum output power and tolerance.

An excess maximum output power has the possibility to interfere to other channels or other systems. A small maximum output power decreases the coverage area.

## 6.2A.1.1.6.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 7UL CA.

NOTE: This test case can't be performed due to lack of appropriate test points.

#### 6.2A.1.1.6.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.2A.1.1.0.

#### 6.2A.1.1.6.4 Test description

Same as in clause 6.2A.1.1.1.4 with following exceptions:

- Instead of Table 6.2A.1.1.1.4.1-1 → use Table 6.2A.1.1.6.4-1.
- Instead of Table 6.2A.1.1.1.5-1 → use Table 6.2A.1.1.6.5-1.

**Table 6.2A.1.1.6.4-1: Test Configuration Table**

NOTE: No test points are defined since there is no configuration satisfying MPR=0dB requirements in RAN4.

#### 6.2A.1.1.6.5 Test Requirements

The EIRP derived in step 8 and TRP derived in step 9 shall not exceed the values specified in Table 6.2A.1.1.6.5-1.

**Table 6.2A.1.1.6.5-1: UE maximum output test requirements for power class 3**

CA configuration	Max TRP (dBm)	Max EIRP (dBm)	Min peak EIRP (dBm)
CA_n257L	23+TT	43	22.4-TT
CA_n260L	23+TT	43	20.6-TT
CA_n261L	23+TT	43	22.4-TT

**Table 6.2A.1.1.6.5-1a: Test Tolerance (Max TRP for Power class 3)**

Test Metric	FR2a	FR2b
Max device size ≤ 30 cm	TBD	TBD

**Table 6.2A.1.1.6.5-1b: Test Tolerance (Min peak EIRP for Power class 3)**

Test Metric	FR2a	FR2b
Max device size ≤ 30 cm	TBD	TBD

#### 6.2A.1.1.7 UE maximum output power - EIRP and TRP for CA (8UL CA)

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- No test points are defined since there is no configuration satisfying MPR=0dB requirements in RAN4.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2, 3 and 4.
- Test Procedures for EIRP beam peak Extreme Conditions are FFS.
- Test Tolerances in the Test Requirement are FFS.

##### 6.2A.1.1.7.1 Test purpose

To verify that the error of the UE maximum output power does not exceed the range prescribed by the specified nominal maximum output power and tolerance.

An excess maximum output power has the possibility to interfere to other channels or other systems. A small maximum output power decreases the coverage area.

## 6.2A.1.1.7.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 8UL CA.

NOTE: This test case can't be performed due to lack of appropriate test points.

## 6.2A.1.1.7.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.2A.1.0.

## 6.2A.1.1.7.4 Test description

Same as in clause 6.2A.1.1.1.4 with following exceptions:

- Instead of Table 6.2A.1.1.1.4.1-1 → use Table 6.2A.1.1.7.4-1.
- Instead of clause 6.2A.1.1.1.4.3 → use clause 6.2A.1.1.7.4.3.
- Instead of Table 6.2A.1.1.1.5-1 → use Table 6.2A.1.1.7.5-1.

**Table 6.2A.1.1.7.4-1: Test Configuration Table**

NOTE: No test points are defined since there is no configuration satisfying MPR=0dB requirements in RAN4.

## 6.2A.1.1.7.5 Test Requirements

The EIRP derived in step 8 and TRP derived in step 9 shall not exceed the values specified in Table 6.2A.1.1.7.5-1.

**Table 6.2A.1.1.7.5-1: UE maximum output test requirements for power class 3**

CA configuration	Max TRP (dBm)	Max EIRP (dBm)	Min peak EIRP (dBm)
CA_n257M	23+TT	43	22.4-TT
CA_n260M	23+TT	43	20.6-TT
CA_n261M	23+TT	43	22.4-TT

**Table 6.2A.1.1.7.5-1a: Test Tolerance (Max TRP for Power class 3)**

Test Metric	FR2a	FR2b
Max device size ≤ 30 cm	TBD	TBD

**Table 6.2A.1.1.7.5-1b: Test Tolerance (Min peak EIRP for Power class 3)**

Test Metric	FR2a	FR2b
Max device size ≤ 30 cm	TBD	TBD

## 6.2A.1.2 UE maximum output power - Spherical coverage

## 6.2A.1.2.1 UE maximum output power - Spherical coverage for CA (2UL CA)

Editor's note: The following aspects are either missing or not yet determined:

- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 400MHz is TBD.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.

## 6.2A.1.2.1.1 Test purpose

To verify that the spatial coverage of the UE for CA in expected directions is acceptable.

6.2A.1.2.1.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 2UL CA.

6.2A.1.2.1.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.2A.1.0.

6.2A.1.2.1.4 Test description

6.2A.1.2.1.4.1 Initial condition

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, and channel bandwidths based on NR operating bands specified in clause 5.5A. All of these configurations shall be tested with applicable test parameters for each channel bandwidth and subcarrier spacing, are shown in Table 6.2A.1.2.1.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.2A.1.2.1.4.1-1: Intra-band Contiguous CA Test Configuration Table (single CC requirement)**

Default Conditions					
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes			Low and High range		
Test CC Combination setting (aggregated BW of the CA configuration) as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE			Highest aggregated BW ( $\leq 400$ MHz aggregated channel bandwidth)		
Test SCS as specified in Table 5.3.5-1			120 kHz		
Test Parameters					
CA Configuration / Aggregated BW			Downlink Configuration	Uplink Configuration	
Test ID	CC & Mapping (NOTE 4)	CBW (MHz)	RB allocation	Modulation	RB allocation (NOTE 1)
1	PCC/CC1	100	-	DFT-s-OFDM QPSK	Inner Full for PC2, PC3 and PC4 Inner_Full_Region1 for PC1
	SCC/CC2	100		-	-
2	PCC/CC1	200		DFT-s-OFDM QPSK	Inner Full for PC2, PC3 and PC4 Inner_Full_Region1 for PC1
	SCC/CC2	200		-	-
NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.					
NOTE 2: CA Configuration Test cumulative aggregated BW settings are checked separately for each CA Configuration, which applicable aggregated channel bandwidths are specified in Table 5.5A.1-1.					
NOTE 3: If the UE supports multiple CC Combinations in the CA Configuration with the same cumulative aggregated BW, only the combination with the lowest PCC ChBW is tested.					
NOTE 4: PCC/CCi and SCC/CCj means PCC is on component carrier CCi and SCC is on component carrier CCj, with CCi or CCj frequencies defined in TS38.508-1 [10].					
NOTE 5: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".					

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.

3. Downlink signals for PCC are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement channels are set according to Table 6.2A.1.2.1.4.1-1.
5. Propagation conditions are set according to Annex B.0
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.2A.1.2.1.4.3

#### 6.2A.1.2.1.4.2 Test procedure

1. Configure PCC and SCC according to Annex C.0, C.1, C.2 and Annex C.3.0 for all downlink physical channels.
2. The SS shall configure SCC as per TS 38.508-1 [10] clause 5.5.1 Procedure to configure SCC(s) for NR RF CA testing. Message contents are defined in clause 6.2A.1.2.1.4.3.
3. SS activates SCC by sending the activation MAC CE (Refer TS 38.321, clauses 5.9, 6.1.3.10). Wait for at least 2 seconds (Refer TS 38.133[25], clause 9.3).
4. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.2A.1.2.1.4.1-1. Since the UL has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC. Messages to configure the appropriate uplink modulation in section 6.2A.1.2.1.4.3.
5. Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
6. Send continuously uplink power control "up" commands in every uplink scheduling information to the UE; allow at least 200 msec to ensure that the UE transmits at its maximum output power. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
7. Through its beam correspondence procedure, DUT refines its TX beam toward that direction depending on DUT's beam correspondence capability which shall match OEM declaration:
  - 7a If the DUT's beam correspondence capability `beamCorrespondenceWithoutUL-BeamSweeping` is supported, then DUT autonomously chooses the corresponding TX beam for PUSCH transmission using downlink reference signals to transmit in the direction of the incoming DL signal, which is based on beam correspondence without relying on UL beam sweeping;
  - 7b If the DUT's beam correspondence capability `beamCorrespondenceWithoutUL-BeamSweeping` is not present, then DUT chooses the TX beam for PUSCH transmission which is based on beam correspondence with relying on both DL measurements on downlink reference signals and network-assisted uplink beam sweeping:
    - 7b.1) DUT uses downlink reference signals to select proper RX beam and uses autonomous beam correspondence to select the TX beam.
    - 7b.2) SS configures M=8 SRS resources to DUT, with the field *spatialRelationInfo* omitted and the field *usage* set as 'beamManagement'. In case DUT supports less than 8 SRS resources, SS configures the number of SRS resources according to the maximum number of SRS resources indicated by UE capability signalling. Additionally, for codebook based PUSCH transmission, SS configures a semi-persistent SRS resource set with the field *usage* as 'codebook'.
    - 7b.3) Based on the TX beam autonomously selected by DUT, DUT chooses TX beams to transmit SRS-resources configured by SS.
    - 7b.4) Based on measurement of the received *beamManagement* SRS, SS chooses the best SRS beam and, if needed, updates the spatial relation information between the semi-persistent *codebook* SRS resources and the SS selected *beamManagement* SRS resource in the activation MAC CE of the semi-persistent SRS resource. The SS indicates in the SRS Resource Indicator (SRI) field in the scheduling grant for PUSCH, if present, the SRS resource within the semi-persistent SRS resource set whose spatial relation is linked to the best detected SRS beam.
    - 7b.5) DUT transmits PUSCH corresponding to the SRS resource indicated by the SRI.

8. Measure UE EIRP value for each grid point according to the EIRP spherical coverage procedure defined in Annex K.1.5.0, and obtain a cumulative distribution function (CDF) of all EIRP dBm values. Alternatively, UE EIRP measurement for each grid point could be done according to Tx Fast spherical coverage procedure defined in Annex K.1.5.1. After a rotation, allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for UE to find the best beam to use. The measuring duration is one active uplink subframe. EIRP is calculated considering both polarizations, theta and phi.
9. Identify the EIRP dBm value corresponding to %-tile (UE power class dependent) value in the applicable test requirement table in section 6.2A.1.2.1.5..

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

#### 6.2A.1.2.1.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with TRANSFORM\_PRECODER\_ENABLED condition in Table 4.6.3-118 PUSCH-Config.

#### 6.2A.1.2.1.5 Test requirement

The defined %-tile EIRP in measurement distribution derived in step 8 shall exceed the values specified in Table 6.2A.1.2.1.5-1 to Table 6.2A.1.2.1.5-4.

**Table 6.2A.1.2.1.5-1: Intra-band Contiguous CA UE spherical coverage for power class 1**

Operating band	Min EIRP at 85%-tile CDF (dBm)
CA_n257D	32.0-TT
CA_n257G	32.0-TT
CA_n260D	30.0-TT
CA_n260G	30.0-TT
CA_n260O	30.0-TT
CA_n261D	32.0-TT
CA_n261G	32.0-TT
CA_n261O	32.0-TT

**Table 6.2A.1.2.1.5-2: Intra-band Contiguous CA UE spherical coverage for power class 2**

Operating band	Min EIRP at 60%-tile CDF (dBm)
CA_n257D	18.0-TT
CA_n257G	18.0-TT
CA_n261D	18.0-TT
CA_n261G	18.0-TT
CA_n261O	18.0-TT

**Table 6.2A.1.2.1.5-3: Intra-band Contiguous CA UE spherical coverage for power class 3 for single band UE or multiband UE declaring  $MB_s = 0$  in all FR2 bands**

Operating band	Min EIRP at 50%-tile CDF (dBm)
CA_n257D	11.5-TT
CA_n257G	11.5-TT
CA_n260D	8-TT
CA_n260G	8-TT
CA_n260O	8-TT
CA_n261D	11.5-TT
CA_n261G	11.5-TT
CA_n261O	11.5-TT

**Table 6.2A.1.2.1.5-3a: UE spherical coverage for power class 3 for multi band UE declaring  $MB_s > 0$  in any FR2 band**

ID	Supported FR2 bands set	Test requirement (dB) (Note 1)				Maximum sum of $MB_s$ , $\sum MB_s$ (dB) (Note 3)	Comments
		CA_n257D/G	CA_n258	CA_n260D/G/O	CA_n261D/G/O		
1	n257, n258	11.5-TT- $MB_s$				1.25	
2	n257, n260	11.5-TT- $MB_s$		8-TT- $MB_s$		0.75	Maximum 0.4 dB relaxation allowed for n260
3	n258, n260			8-TT- $MB_s$		0.75	Maximum 0.4 dB relaxation allowed for n260
4	n258, n261				11.5-TT- $MB_s$	1.25	
5	n260, n261			8-TT- $MB_s$	11.5-TT- $MB_s$	0.75	No relaxation allowed for n260
6	n257, n258, n260	11.5-TT- $MB_s$		8-TT- $MB_s$		1.75	Maximum 0.4 dB relaxation allowed for n260
7	n257, n258, n261	11.5-TT- $MB_s$			11.5-TT- $MB_s$	1.75	
8	n257, n260, n261	11.5-TT- $MB_s$		8-TT- $MB_s$	11.5-TT- $MB_s$	1.25	Maximum 0.4 dB relaxation allowed for n260
9	n258, n260, n261			8-TT- $MB_s$	11.5-TT- $MB_s$	1.25	Maximum 0.4 dB relaxation allowed for n260
10	n257, n258, n260, n261	11.5-TT- $MB_s$		8-TT- $MB_s$	11.5-TT- $MB_s$	1.75	Maximum 0.4 dB relaxation allowed for n260

Note 1:  $MB_s$  is the Multiband Relaxation factor declared by the UE for the tested band in Table A.4.3.9-3 of TS38.508-2 [11]. This declaration shall fulfil the requirements in clause 6.2.1.1.3.3.

Note 2: All UE supported bands needs to be tested to ensure the multiband relaxation declaration is compliant

Note 3: Max allowed sum of  $MB_s$  over all supported FR2 bands as defined in clause 6.2.1.1.3.3

**Table 6.2A.1.2.1.5-4: Intra-band Contiguous CA UE spherical coverage for power class 4**

Operating band	Min EIRP at 20%-tile CDF (dBm)
CA_n257D	25-TT
CA_n257G	25-TT
CA_n260D	19-TT
CA_n260G	19-TT
CA_n260O	19-TT
CA_n261D	25-TT
CA_n261G	25-TT
CA_n261O	25-TT

**Table 6.2A.1.2.1.5-5: Test Tolerance (Spherical coverage) (Aggregated BW  $\leq$  400MHz)**

Test Metric	FR2a	FR2b
IFF (Max device size $\leq$ 30 cm)	2.58 dB	2.58 dB

#### 6.2A.1.2.2 UE maximum output power - Spherical coverage for CA (3UL CA)

Editor's note: The following aspects are either missing or not yet determined:

- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 400MHz is TBD.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.

##### 6.2A.1.2.2.1 Test purpose

To verify that the spatial coverage of the UE for CA in expected directions is acceptable.

6.2A.1.2.2.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 3UL CA.

6.2A.1.2.2.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.2A.1.0.

6.2A.1.2.2.4 Test description

Same as in clause 6.2A.1.2.1.4 with following exceptions:

- Instead of Table 6.2A.1.2.1.4.1-1 → use Table 6.2A.1.2.2.4-1.
- Instead of Table 6.2A.1.2.1.5-1 to 5 → use Table 6.2A.1.2.2.5-1 to 5.

**Table 6.2A.1.2.2.4-1: Intra-band Contiguous CA Test Configuration Table (single CC requirement)**

Default Conditions					
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes			Low and High range		
Test CC Combination setting (aggregated BW of the CA configuration) as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE			Highest aggregated BW (≤ 400 MHz aggregated channel bandwidth)		
Test SCS as specified in Table 5.3.5-1			120 kHz		
Test Parameters					
CA Configuration / Aggregated BW			Downlink Configuration	Uplink Configuration	
Test ID	CC & Mapping (NOTE 4)	CBW (MHz)	RB allocation	Modulation	RB allocation (NOTE 1)
1	PCC/CC1	100	-	DFT-s-OFDM QPSK	Inner Full
	SCC/CC2	100		-	-
	SCC/CC3	100		-	-
NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.					
NOTE 2: CA Configuration Test cumulative aggregated BW settings are checked separately for each CA Configuration, which applicable aggregated channel bandwidths are specified in Table 5.5A.1-1.					
NOTE 3: If the UE supports multiple CC Combinations in the CA Configuration with the same cumulative aggregated BW, only the combination with the lowest PCC ChBW is tested.					
NOTE 4: PCC/CC <sub>i</sub> and SCC/CC <sub>j</sub> means PCC is on component carrier CC <sub>i</sub> and SCC is on component carrier CC <sub>j</sub> , with CC <sub>i</sub> or CC <sub>j</sub> frequencies defined in TS38.508-1 [10].					
NOTE 5: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".					

6.2A.1.2.2.5 Test requirement

The defined %-tile EIRP in measurement distribution derived in step 8 shall exceed the values specified in Table 6.2A.1.2.2.5-1 to Table 6.2A.1.2.2.5-4.

**Table 6.2A.1.2.2.5-1: Intra-band Contiguous CA UE spherical coverage for power class 1**

Operating band	Min EIRP at 85%-tile CDF (dBm)
CA_n257H	32.0-TT
CA_n260H	30.0-TT
CA_n260P	30.0-TT
CA_n261H	32.0-TT
CA_n261P	32.0-TT



**Table 6.2A.1.2.2.5-2: Intra-band Contiguous CA UE spherical coverage for power class 2**

Operating band	Min EIRP at 60%-tile CDF (dBm)
CA_n257H	18.0-TT
CA_n261H	18.0-TT
CA_n261P	18.0-TT

**Table 6.2A.1.2.2.5-3: Intra-band Contiguous CA UE spherical coverage for power class 3 for single band UE or multiband UE declaring MB<sub>s</sub> = 0 in all FR2 bands**

Operating band	Min EIRP at 50%-tile CDF (dBm)
CA_n257H	11.5-TT
CA_n260H	8-TT
CA_n260P	8-TT
CA_n261H	11.5-TT
CA_n261P	11.5-TT

**Table 6.2A.1.2.2.5-3a: UE spherical coverage for power class 3 for multi band UE declaring MB<sub>s</sub>>0 in any FR2 band**

ID	Supported FR2 bands set	Test requirement (dB) (Note 1)				Maximum sum of MB <sub>s</sub> , ∑MB <sub>s</sub> (dB) (Note 3)	Comments
		CA_n257H	CA_n258	CA_n260H/ P	CA_n261H/P		
1	n257, n258	11.5-TT-MB <sub>s</sub>				1.25	
2	n257, n260	11.5-TT-MB <sub>s</sub>		8-TT-MB <sub>s</sub>		0.75	Maximum 0.4 dB relaxation allowed for n260
3	n258, n260			8-TT-MB <sub>s</sub>		0.75	Maximum 0.4 dB relaxation allowed for n260
4	n258, n261				11.5-TT-MB <sub>s</sub>	1.25	
5	n260, n261			8-TT-MB <sub>s</sub>	11.5-TT-MB <sub>s</sub>	0.75	No relaxation allowed for n260
6	n257, n258, n260	11.5-TT-MB <sub>s</sub>		8-TT-MB <sub>s</sub>		1.75	Maximum 0.4 dB relaxation allowed for n260
7	n257, n258, n261	11.5-TT-MB <sub>s</sub>			11.5-TT-MB <sub>s</sub>	1.75	
8	n257, n260, n261	11.5-TT-MB <sub>s</sub>		8-TT-MB <sub>s</sub>	11.5-TT-MB <sub>s</sub>	1.25	Maximum 0.4 dB relaxation allowed for n260
9	n258, n260, n261			8-TT-MB <sub>s</sub>	11.5-TT-MB <sub>s</sub>	1.25	Maximum 0.4 dB relaxation allowed for n260
10	n257, n258, n260, n261	11.5-TT-MB <sub>s</sub>		8-TT-MB <sub>s</sub>	11.5-TT-MB <sub>s</sub>	1.75	Maximum 0.4 dB relaxation allowed for n260

Note 1: MB<sub>s</sub> is the Multiband Relaxation factor declared by the UE for the tested band in Table A.4.3.9-3 of TS38.508-2 [11]. This declaration shall fulfil the requirements in clause 6.2.1.1.3.3.

Note 2: All UE supported bands needs to be tested to ensure the multiband relaxation declaration is compliant

Note 3: Max allowed sum of MB<sub>s</sub> over all supported FR2 bands as defined in clause 6.2.1.1.3.3

**Table 6.2A.1.2.2.5-4: Intra-band Contiguous CA UE spherical coverage for power class 4**

Operating band	Min EIRP at 20%-tile CDF (dBm)
CA_n257H	25-TT
CA_n260H	19-TT
CA_n260P	19-TT
CA_n261H	25-TT
CA_n261P	25-TT

**Table 6.2A.1.2.2.5-5: Test Tolerance (Spherical coverage) (Aggregated BW ≤ 400MHz)**

Test Metric	FR2a	FR2b
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IFF (Max device size ≤ 30 cm)	2.58 dB	2.58 dB
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### 6.2A.1.2.3 UE maximum output power - Spherical coverage for CA (4UL CA)

Editor's note: The following aspects are either missing or not yet determined:

- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 400MHz is TBD.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.

#### 6.2A.1.2.3.1 Test purpose

To verify that the spatial coverage of the UE for CA in expected directions is acceptable.

#### 6.2A.1.2.3.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 4UL CA.

#### 6.2A.1.2.3.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.2A.1.0.

#### 6.2A.1.2.3.4 Test description

Same as in clause 6.2A.1.2.1.4 with following exceptions:

- Instead of Table 6.2A.1.2.1.4.1-1 → use Table 6.2A.1.2.3.4-1.
- Instead of Table 6.2A.1.2.1.5-1 to 5 → use Table 6.2A.1.2.3.5-1 to 5.

**Table 6.2A.1.2.3.4-1: Intra-band Contiguous CA Test Configuration Table (single CC requirement)**

Default Conditions					
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes			Low and High range		
Test CC Combination setting (cumulative aggregated BW of the CA configuration) as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE			Highest aggregated BW (≤ 400 MHz aggregated channel bandwidth)		
Test SCS as specified in Table 5.3.5-1			120 kHz		
Test Parameters					
CA Configuration / Aggregated BW			Downlink Configuration	Uplink Configuration	
Test ID	CC & Mapping (NOTE 4)	ChBw	RB allocation	Modulation	RB allocation (NOTE 1)
1	PCC/CC1	100	-	DFT-s-OFDM QPSK	Inner Full
	SCC/CC2	100		-	-
	SCC/CC3	100		-	-
	SCC/CC4	100		-	-
NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.					
NOTE 2: CA Configuration Test cumulative aggregated BW settings are checked separately for each CA Configuration, which applicable aggregated channel bandwidths are specified in Table 5.5A.1-1.					
NOTE 3: If the UE supports multiple CC Combinations in the CA Configuration with the same cumulative aggregated BW, only the combination with the lowest PCC ChBw is tested.					
NOTE 4: PCC/CC <sub>i</sub> and SCC/CC <sub>j</sub> means PCC is on component carrier CC <sub>i</sub> and SCC is on component carrier CC <sub>j</sub> , with CC <sub>i</sub> or CC <sub>j</sub> frequencies defined in TS38.508-1 [10].					
NOTE 5: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range					

between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier”.

6.2A.1.2.3.5 Test requirement

The defined %-tile EIRP in measurement distribution derived in step 8 shall exceed the values specified in Table 6.2A.1.2.3.5-1 to Table 6.2A.1.2.3.5-4.

**Table 6.2A.1.2.3.5-1: Intra-band Contiguous CA UE spherical coverage for power class 1**

Operating band	Min EIRP at 85%-tile CDF (dBm)
CA_n257I	32.0-TT
CA_n260I	30.0-TT
CA_n260Q	30.0-TT
CA_n261I	32.0-TT
CA_n261Q	32.0-TT

**Table 6.2A.1.2.3.5-2: Intra-band Contiguous CA UE spherical coverage for power class 2**

Operating band	Min EIRP at 60%-tile CDF (dBm)
CA_n257I	32.0-TT
CA_n261I	32.0-TT
CA_n261Q	32.0-TT

**Table 6.2A.1.2.3.5-3: Intra-band Contiguous CA UE spherical coverage for power class 3 for single band UE or multiband UE declaring MB<sub>s</sub> = 0 in all FR2 bands**

Operating band	Min EIRP at 50%-tile CDF (dBm)
CA_n257I	11.5-TT
CA_n260I	8-TT
CA_n260Q	8-TT
CA_n261I	11.5-TT
CA_n261Q	11.5-TT

**Table 6.2A.1.2.3.5-3a: UE spherical coverage for power class 3 for multi band UE declaring MB<sub>s</sub>>0 in any FR2 band**

ID	Supported FR2 bands set	Test requirement (dB) (Note 1)				Maximum sum of MB <sub>s</sub> , ΣMB <sub>s</sub> (dB) (Note 3)	Comments
		CA_n257I	CA_n258	CA_n260I/Q	CA_n261I/Q		
1	n257, n258	11.5-TT-MB <sub>s</sub>				1.25	
2	n257, n260	11.5-TT-MB <sub>s</sub>		8-TT-MB <sub>s</sub>		0.75	Maximum 0.4 dB relaxation allowed for n260
3	n258, n260			8-TT-MB <sub>s</sub>		0.75	Maximum 0.4 dB relaxation allowed for n260
4	n258, n261				11.5-TT-MB <sub>s</sub>	1.25	
5	n260, n261			8-TT-MB <sub>s</sub>	11.5-TT-MB <sub>s</sub>	0.75	No relaxation allowed for n260
6	n257, n258, n260	11.5-TT-MB <sub>s</sub>		8-TT-MB <sub>s</sub>		1.75	Maximum 0.4 dB relaxation allowed for n260
7	n257, n258, n261	11.5-TT-MB <sub>s</sub>			11.5-TT-MB <sub>s</sub>	1.75	
8	n257, n260, n261	11.5-TT-MB <sub>s</sub>		8-TT-MB <sub>s</sub>	11.5-TT-MB <sub>s</sub>	1.25	Maximum 0.4 dB relaxation allowed for n260
9	n258, n260, n261			8-TT-MB <sub>s</sub>	11.5-TT-MB <sub>s</sub>	1.25	Maximum 0.4 dB relaxation allowed for n260
10	n257, n258, n260, n261	11.5-TT-MB <sub>s</sub>		8-TT-MB <sub>s</sub>	11.5-TT-MB <sub>s</sub>	1.75	Maximum 0.4 dB relaxation allowed for n260

Note 1:	MB <sub>s</sub> is the Multiband Relaxation factor declared by the UE for the tested band in Table A.4.3.9-3 of TS38.508-2 [11]. This declaration shall fulfil the requirements in clause 6.2.1.1.3.3.
Note 2:	All UE supported bands needs to be tested to ensure the multiband relaxation declaration is compliant
Note 3:	Max allowed sum of MB <sub>s</sub> over all supported FR2 bands as defined in clause 6.2.1.1.3.3

**Table 6.2A.1.2.3.5-4: Intra-band Contiguous CA UE spherical coverage for power class 4**

Operating band	Min EIRP at 20%-tile CDF (dBm)
CA_n257I	25-TT
CA_n260I	19-TT
CA_n260Q	19-TT
CA_n261I	25-TT
CA_n261Q	25-TT

**Table 6.2A.1.2.3.5-5: Test Tolerance (Spherical coverage) (Aggregated BW ≤ 400MHz)**

Test Metric	FR2a	FR2b
IFF (Max device size ≤ 30 cm)	2.58 dB	2.58 dB

#### 6.2A.1.2.4 UE maximum output power - Spherical coverage for CA (5UL CA)

Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:

- Test configuration table is TBD.
- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 400MHz is TBD.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.

##### 6.2A.1.2.4.1 Test purpose

To verify that the spatial coverage of the UE for CA in expected directions is acceptable.

##### 6.2A.1.2.4.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 5UL CA.

##### 6.2A.1.2.4.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.2A.1.0.

##### 6.2A.1.2.4.4 Test description

Same as in clause 6.2A.1.2.1.4 with following exceptions:

- Instead of Table 6.2A.1.2.1.4.1-1 → use Table 6.2A.1.2.4.4-1.
- Instead of Table 6.2A.1.2.1.5-1 to 5 → use Table 6.2A.1.2.4.5-1 to 5.

**Table 6.2A.1.2.4.4-1: Test Configuration Table**

FFS

##### 6.2A.1.2.4.5 Test requirement

The defined %-tile EIRP in measurement distribution derived in step 8 shall exceed the values specified in Table 6.2A.1.2.4.5-1 to Table 6.2A.1.2.4.5-4.

Table 6.2A.1.2.4.5-1: Intra-band Contiguous CA UE spherical coverage for power class 1

Operating band	Min EIRP at 85%-tile CDF (dBm)
CA_n257J	32.0-TT
CA_n260J	30.0-TT
CA_n261J	32.0-TT

Table 6.2A.1.2.4.5-2: Intra-band Contiguous CA UE spherical coverage for power class 2

Operating band	Min EIRP at 60%-tile CDF (dBm)
CA_n257J	18.0-TT
CA_n261J	18.0-TT

Table 6.2A.1.2.4.5-3: Intra-band Contiguous CA UE spherical coverage for power class 3 for single band UE or multiband UE declaring  $MB_s = 0$  in all FR2 bands

Operating band	Min EIRP at 50%-tile CDF (dBm)
CA_n257J	11.5-TT
CA_n260J	8-TT
CA_n261J	11.5-TT

Table 6.2A.1.2.4.5-3a: UE spherical coverage for power class 3 for multi band UE declaring  $MB_s > 0$  in any FR2 band

ID	Supported FR2 bands set	Test requirement (dB) (Note 1)				Maximum sum of $MB_s$ , $\sum MB_s$ (dB) (Note 3)	Comments
		CA_n257J	CA_n258	CA_n260J	CA_n261J		
1	n257, n258	11.5-TT- $MB_s$				1.25	
2	n257, n260	11.5-TT- $MB_s$		8-TT- $MB_s$		0.75	Maximum 0.4 dB relaxation allowed for n260
3	n258, n260			8-TT- $MB_s$		0.75	Maximum 0.4 dB relaxation allowed for n260
4	n258, n261				11.5-TT- $MB_s$	1.25	
5	n260, n261			8-TT- $MB_s$	11.5-TT- $MB_s$	0.75	No relaxation allowed for n260
6	n257, n258, n260	11.5-TT- $MB_s$		8-TT- $MB_s$		1.75	Maximum 0.4 dB relaxation allowed for n260
7	n257, n258, n261	11.5-TT- $MB_s$			11.5-TT- $MB_s$	1.75	
8	n257, n260, n261	11.5-TT- $MB_s$		8-TT- $MB_s$	11.5-TT- $MB_s$	1.25	Maximum 0.4 dB relaxation allowed for n260
9	n258, n260, n261			8-TT- $MB_s$	11.5-TT- $MB_s$	1.25	Maximum 0.4 dB relaxation allowed for n260
10	n257, n258, n260, n261	11.5-TT- $MB_s$		8-TT- $MB_s$	11.5-TT- $MB_s$	1.75	Maximum 0.4 dB relaxation allowed for n260
Note 1: $MB_s$ is the Multiband Relaxation factor declared by the UE for the tested band in Table A.4.3.9-3 of TS38.508-2 [11]. This declaration shall fulfil the requirements in clause 6.2.1.1.3.3.							
Note 2: All UE supported bands needs to be tested to ensure the multiband relaxation declaration is compliant							
Note 3: Max allowed sum of $MB_s$ over all supported FR2 bands as defined in clause 6.2.1.1.3.3							

Table 6.2A.1.2.4.5-4: Intra-band Contiguous CA UE spherical coverage for power class 4

Operating band	Min EIRP at 20%-tile CDF (dBm)
CA_n257J	25-TT
CA_n260J	19-TT
CA_n261J	25-TT

**Table 6.2A.1.2.4.5-5: Test Tolerance (Spherical coverage) (400MHz < Aggregated BW ≤ 800MHz)**

Test Metric	FR2a	FR2b
IFF (Max device size ≤ 30 cm)	FFS	FFS

6.2A.1.2.5 UE maximum output power - Spherical coverage for CA (6UL CA)

Editor’s note: This clause is incomplete. The following aspects are either missing or not yet determined:

- Test configuration table is TBD.
- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 400MHz is TBD.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.

6.2A.1.2.5.1 Test purpose

To verify that the spatial coverage of the UE for CA in expected directions is acceptable.

6.2A.1.2.5.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 6UL CA.

6.2A.1.2.5.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.2A.1.0.

6.2A.1.2.5.4 Test description

Same as in clause 6.2A.1.2.1.4 with following exceptions:

- Instead of Table 6.2A.1.2.1.4.1-1 → use Table 6.2A.1.2.5.4-1.
- Instead of Table 6.2A.1.2.1.5-1 to 5 → use Table 6.2A.1.2.5.5-1 to 5.

**Table 6.2A.1.2.5.4-1: Test Configuration Table**

FFS

6.2A.1.2.5.5 Test requirement

The defined %-tile EIRP in measurement distribution derived in step 8 shall exceed the values specified in Table 6.2A.1.2.5.5-1 to Table 6.2A.1.2.5.5-4.

**Table 6.2A.1.2.5.5-1: Intra-band Contiguous CA UE spherical coverage for power class 1**

Operating band	Min EIRP at 85%-tile CDF (dBm)
CA_n257K	32.0-TT
CA_n260K	30.0-TT
CA_n261K	32.0-TT

**Table 6.2A.1.2.5.5-2: Intra-band Contiguous CA UE spherical coverage for power class 2**

Operating band	Min EIRP at 60%-tile CDF (dBm)
CA_n257K	18.0-TT
CA_n261K	18.0-TT

**Table 6.2A.1.2.5.5-3: Intra-band Contiguous CA UE spherical coverage for power class 3 for single band UE or multiband UE declaring MB<sub>s</sub> = 0 in all FR2 bands**

Operating band	Min EIRP at 50 <sup>th</sup> -tile CDF (dBm)
CA_n257K	11.5-TT
CA_n260K	8-TT
CA_n261K	11.5-TT

**Table 6.2A.1.2.5.5-3a: UE spherical coverage for power class 3 for multi band UE declaring MB<sub>s</sub>>0 in any FR2 band**

ID	Supported FR2 bands set	Test requirement (dB) (Note 1)				Maximum sum of MB <sub>s</sub> , ∑MB <sub>s</sub> (dB) (Note 3)	Comments
		CA_n257J	CA_n258	CA_n260J	CA_n261J		
1	n257, n258	11.5-TT-MB <sub>s</sub>				1.25	
2	n257, n260	11.5-TT-MB <sub>s</sub>		8-TT-MB <sub>s</sub>		0.75	Maximum 0.4 dB relaxation allowed for n260
3	n258, n260			8-TT-MB <sub>s</sub>		0.75	Maximum 0.4 dB relaxation allowed for n260
4	n258, n261				11.5-TT-MB <sub>s</sub>	1.25	
5	n260, n261			8-TT-MB <sub>s</sub>	11.5-TT-MB <sub>s</sub>	0.75	No relaxation allowed for n260
6	n257, n258, n260	11.5-TT-MB <sub>s</sub>		8-TT-MB <sub>s</sub>		1.75	Maximum 0.4 dB relaxation allowed for n260
7	n257, n258, n261	11.5-TT-MB <sub>s</sub>			11.5-TT-MB <sub>s</sub>	1.75	
8	n257, n260, n261	11.5-TT-MB <sub>s</sub>		8-TT-MB <sub>s</sub>	11.5-TT-MB <sub>s</sub>	1.25	Maximum 0.4 dB relaxation allowed for n260
9	n258, n260, n261			8-TT-MB <sub>s</sub>	11.5-TT-MB <sub>s</sub>	1.25	Maximum 0.4 dB relaxation allowed for n260
10	n257, n258, n260, n261	11.5-TT-MB <sub>s</sub>		8-TT-MB <sub>s</sub>	11.5-TT-MB <sub>s</sub>	1.75	Maximum 0.4 dB relaxation allowed for n260

Note 1: MB<sub>s</sub> is the Multiband Relaxation factor declared by the UE for the tested band in Table A.4.3.9-3 of TS38.508-2 [11]. This declaration shall fulfil the requirements in clause 6.2.1.1.3.3.

Note 2: All UE supported bands needs to be tested to ensure the multiband relaxation declaration is compliant

Note 3: Max allowed sum of MB<sub>s</sub> over all supported FR2 bands as defined in clause 6.2.1.1.3.3

**Table 6.2A.1.2.5.5-4: Intra-band Contiguous CA UE spherical coverage for power class 4**

Operating band	Min EIRP at 20%-tile CDF (dBm)
CA_n257K	25-TT
CA_n260K	19-TT
CA_n261K	25-TT

**Table 6.2A.1.2.5.5-5: Test Tolerance (Spherical coverage) (400MHz < Aggregated BW ≤ 800MHz)**

Test Metric	FR2a	FR2b
IFF (Max device size ≤ 30 cm)	FFS	FFS

6.2A.1.2.6 UE maximum output power - Spherical coverage for CA (7UL CA)

Editor’s note: This clause is incomplete. The following aspects are either missing or not yet determined:

- Test configuration table is TBD.
- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 400MHz is TBD.

- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.

6.2A.1.2.6.1 Test purpose

To verify that the spatial coverage of the UE for CA in expected directions is acceptable.

6.2A.1.2.6.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 7UL CA.

6.2A.1.2.6.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.2A.1.0.

6.2A.1.2.6.4 Test description

Same as in clause 6.2A.1.2.1.4 with following exceptions:

- Instead of Table 6.2A.1.2.1.4.1-1 → use Table 6.2A.1.2.6.4-1.
- Instead of Table 6.2A.1.2.1.5-1 to Table 6.2A.1.2.1.5-5 → use Table 6.2A.1.2.6.5-1 to Table 6.2A.1.2.6.5-5.

**Table 6.2A.1.2.6.4-1: Test Configuration Table**

FFS

6.2A.1.2.6.5 Test requirement

The defined %-tile EIRP in measurement distribution derived in step 8 shall exceed the values specified in Table 6.2A.1.2.6.5-1 to Table 6.2A.1.2.6.5-4.

**Table 6.2A.1.2.6.5-1: Intra-band Contiguous CA UE spherical coverage for power class 1**

Operating band	Min EIRP at 85%-tile CDF (dBm)
CA_n257L	32.0-TT
CA_n260L	30.0-TT
CA_n261L	32.0-TT

**Table 6.2A.1.2.6.5-2: Intra-band Contiguous CA UE spherical coverage for power class 2**

Operating band	Min EIRP at 60%-tile CDF (dBm)
CA_n257L	18.0-TT
CA_n261L	18.0-TT

**Table 6.2A.1.2.6.5-3: Intra-band Contiguous CA UE spherical coverage for power class 3 for single band UE or multiband UE declaring MB<sub>s</sub> = 0 in all FR2 bands**

Operating band	Min EIRP at 50%-tile CDF (dBm)
CA_n257L	11.5-TT
CA_n260L	8-TT
CA_n261L	11.5-TT

**Table 6.2A.1.2.6.5-3a: UE spherical coverage for power class 3 for multi band UE declaring MB<sub>s</sub>>0 in any FR2 band**

ID	Supported FR2 bands set	Test requirement (dB) (Note 1)	Maximum sum of MB <sub>s</sub> , ∑MB <sub>s</sub> (dB) (Note 3)	Comments



		CA_n257L	CA_n258	CA_n260L	CA_n261L		
1	n257, n258	11.5-TT-MB <sub>s</sub>				1.25	
2	n257, n260	11.5-TT-MB <sub>s</sub>		8-TT-MB <sub>s</sub>		0.75	Maximum 0.4 dB relaxation allowed for n260
3	n258, n260			8-TT-MB <sub>s</sub>		0.75	Maximum 0.4 dB relaxation allowed for n260
4	n258, n261				11.5-TT-MB <sub>s</sub>	1.25	
5	n260, n261			8-TT-MB <sub>s</sub>	11.5-TT-MB <sub>s</sub>	0.75	No relaxation allowed for n260
6	n257, n258, n260	11.5-TT-MB <sub>s</sub>		8-TT-MB <sub>s</sub>		1.75	Maximum 0.4 dB relaxation allowed for n260
7	n257, n258, n261	11.5-TT-MB <sub>s</sub>			11.5-TT-MB <sub>s</sub>	1.75	
8	n257, n260, n261	11.5-TT-MB <sub>s</sub>		8-TT-MB <sub>s</sub>	11.5-TT-MB <sub>s</sub>	1.25	Maximum 0.4 dB relaxation allowed for n260
9	n258, n260, n261			8-TT-MB <sub>s</sub>	11.5-TT-MB <sub>s</sub>	1.25	Maximum 0.4 dB relaxation allowed for n260
10	n257, n258, n260, n261	11.5-TT-MB <sub>s</sub>		8-TT-MB <sub>s</sub>	11.5-TT-MB <sub>s</sub>	1.75	Maximum 0.4 dB relaxation allowed for n260

Note 1: MB<sub>s</sub> is the Multiband Relaxation factor declared by the UE for the tested band in Table A.4.3.9-3 of TS38.508-2 [11]. This declaration shall fulfil the requirements in clause 6.2.1.1.3.3.

Note 2: All UE supported bands needs to be tested to ensure the multiband relaxation declaration is compliant

Note 3: Max allowed sum of MB<sub>s</sub> over all supported FR2 bands as defined in clause 6.2.1.1.3.3

**Table 6.2A.1.2.6.5-4: Intra-band Contiguous CA UE spherical coverage for power class 4**

Operating band	Min EIRP at 20%-tile CDF (dBm)
CA_n257L	25-TT
CA_n260L	19-TT
CA_n261L	25-TT

**Table 6.2A.1.2.6.5-5: Test Tolerance (Spherical coverage) (400MHz < Aggregated BW ≤ 800MHz)**

Test Metric	FR2a	FR2b
IFF (Max device size ≤ 30 cm)	FFS	FFS

#### 6.2A.1.2.7 UE maximum output power - Spherical coverage for CA (8UL CA)

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- Test configuration table is TBD.
- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 400MHz is TBD.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.

##### 6.2A.1.2.7.1 Test purpose

To verify that the spatial coverage of the UE for CA in expected directions is acceptable.

##### 6.2A.1.2.7.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 8UL CA.

##### 6.2A.1.2.7.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.2A.1.0.

## 6.2A.1.2.7.4 Test description

Same as in clause 6.2A.1.2.1.4 with following exceptions:

- Instead of Table 6.2A.1.2.1.4.1-1 → use Table 6.2A.1.2.7.4-1.
- Instead of Table 6.2A.1.2.1.5-1 to Table 6.2A.1.2.1.5-5 → use Table 6.2A.1.2.7.5-1 to Table 6.2A.1.2.7.5-5.

**Table 6.2A.1.2.7.4-1: Test Configuration Table**

FFS

## 6.2A.1.2.7.5 Test requirement

The defined %-tile EIRP in measurement distribution derived in step 8 shall exceed the values specified in Table 6.2A.1.2.7.5-1 to Table 6.2A.1.2.7.5-4.

**Table 6.2A.1.2.7.5-1: Intra-band Contiguous CA UE spherical coverage for power class 1**

Operating band	Min EIRP at 85%-tile CDF (dBm)
CA_n257M	32.0-TT
CA_n260M	30.0-TT
CA_n261M	32.0-TT

**Table 6.2A.1.2.7.5-2: Intra-band Contiguous CA UE spherical coverage for power class 2**

Operating band	Min EIRP at 60%-tile CDF (dBm)
CA_n257M	18.0-TT
CA_n261M	18.0-TT

**Table 6.2A.1.2.7.5-3: Intra-band Contiguous CA UE spherical coverage for power class 3 for single band UE or multiband UE declaring  $MB_s = 0$  in all FR2 bands**

Operating band	Min EIRP at 50%-tile CDF (dBm)
CA_n257M	11.5-TT
CA_n260M	8-TT
CA_n261M	11.5-TT

**Table 6.2A.1.2.7.5-3a: UE spherical coverage for power class 3 for multi band UE declaring  $MB_s > 0$  in any FR2 band**

ID	Supported FR2 bands set	Test requirement (dB) (Note 1)				Maximum sum of $MB_s$ , $\sum MB_s$ (dB) (Note 3)	Comments
		CA_n257M	CA_n258	CA_n260M	CA_n261M		
1	n257, n258	11.5-TT- $MB_s$				1.25	
2	n257, n260	11.5-TT- $MB_s$		8-TT- $MB_s$		0.75	Maximum 0.4 dB relaxation allowed for n260
3	n258, n260			8-TT- $MB_s$		0.75	Maximum 0.4 dB relaxation allowed for n260
4	n258, n261				11.5-TT- $MB_s$	1.25	
5	n260, n261			8-TT- $MB_s$	11.5-TT- $MB_s$	0.75	No relaxation allowed for n260
6	n257, n258, n260	11.5-TT- $MB_s$		8-TT- $MB_s$		1.75	Maximum 0.4 dB relaxation allowed for n260
7	n257, n258, n261	11.5-TT- $MB_s$			11.5-TT- $MB_s$	1.75	
8	n257, n260, n261	11.5-TT- $MB_s$		8-TT- $MB_s$	11.5-TT- $MB_s$	1.25	Maximum 0.4 dB relaxation allowed for n260
9	n258, n260, n261			8-TT- $MB_s$	11.5-TT- $MB_s$	1.25	Maximum 0.4 dB relaxation allowed for n260

10	n257, n258, n260, n261	11.5-TT-MB <sub>s</sub>		8-TT-MB <sub>s</sub>	11.5-TT-MB <sub>s</sub>	1.75	Maximum 0.4 dB relaxation allowed for n260
Note 1: MB <sub>s</sub> is the Multiband Relaxation factor declared by the UE for the tested band in Table A.4.3.9-3 of TS38.508-2 [11]. This declaration shall fulfil the requirements in clause 6.2.1.1.3.3.							
Note 2: All UE supported bands needs to be tested to ensure the multiband relaxation declaration is compliant							
Note 3: Max allowed sum of MB <sub>s</sub> over all supported FR2 bands as defined in clause 6.2.1.1.3.3							

**Table 6.2A.1.2.7.5-4: Intra-band Contiguous CA UE spherical coverage for power class 4**

Operating band	Min EIRP at 20%-tile CDF (dBm)
CA_n257M	25-TT
CA_n260M	19-TT
CA_n261M	25-TT

**Table 6.2A.1.2.7.5-5: Test Tolerance (Spherical coverage) (400MHz < Aggregated BW ≤ 800MHz)**

Test Metric	FR2a	FR2b
IFF (Max device size ≤ 30 cm)	FFS	FFS

## 6.2A.2 UE maximum output power reduction for CA

### 6.2A.2.0 Minimum conformance requirements

#### 6.2A.2.0.1 General

The UE is defined to be configured for CA operation when it has at least one of UL or DL configured for CA. In CA operation, the UE may reduce its maximum output power due to higher order modulations and transmit bandwidth configurations. This Maximum Power Reduction (MPR) is defined in subclauses below.

When the maximum output power of a UE is modified by MPR, the power limits specified in subclause 6.2A.4.0 apply.

The requirements in the following subclauses are only applicable to the following CA configurations:

- intra-band contiguous uplink CA, with the aggregated channel bandwidth up to 800 MHz.
- intra-band non-contiguous uplink CA with UL frequency separation no greater than 1400 MHz, and no more than 3 sub-blocks. A sub-block may consist of single CC or multiple contiguous CCs.
- In case the CA configuration consists of a single UL CC, MPR for contiguous UL CA applies and where necessary,  $BW_{channel}$  shall be used as  $BW_{channel\_CA}$ .

#### 6.2A.2.0.2 Maximum output power reduction for power class 1

For power class 1, MPR for intra-band contiguous UL CA with contiguous allocations within the cumulative aggregated bandwidth is defined as:

$$MPR_{C\_CA} = \max(MPR_{WT\_C\_CA}, MPR_{narrow})$$

Where,

$MPR_{narrow} = 14.4$  dB, when  $BW_{alloc, RB}$  is less than or equal to 1.44 MHz,  $MPR_{narrow} = 10$  dB, when  $1.44$  MHz <  $BW_{alloc, RB} \leq 10.8$  MHz, where  $BW_{alloc, RB}$  is the bandwidth of the RB allocation size.

$MPR_{WT\_C\_CA}$  is the maximum power reduction due to modulation orders, transmit bandwidth configurations, and waveform types.  $MPR_{WT\_C\_CA}$  is defined in Table 6.2A.2.0.2-1.

**Table 6.2A.2.0.2-1: Maximum power reduction ( $MPR_{WT\_C\_CA}$ ) for UE power class 1**

Waveform Type	Cumulative aggregated channel bandwidth
---------------	---

		< 400 MHz	≥ 400 MHz and < 800 MHz	≥ 800 MHz and ≤ 1400 MHz	> 1400 MHz and ≤ 2400 MHz
DFT-s-OFDM	Pi/2 BPSK	≤ 5.5 <sup>1</sup>	7.7 <sup>1</sup>	8.2	≤ 8.7
	QPSK	≤ 6.5 <sup>1</sup>	8.7 <sup>1</sup>	9.7	≤ 9.7
	16 QAM	≤ 6.5	8.7	9.2	≤ 9.7
	64 QAM	≤ 9.0	10.7	11.2	≤ 11.7
CP-OFDM	QPSK	≤ 6.5	8.7	8.7	≤ 9.7
	16 QAM	≤ 6.5	8.7	8.7	≤ 9.7
	64 QAM	≤ 9.0	10.7	11.2	≤ 11.7
NOTE 1: Void.					

In case of a contiguous RB, DFT-s-BPSK or DFT-s-QPSK UL allocation in a single CC of a CA configuration with contiguous CCs, and whose cumulative aggregated BW ≤ 400 MHz,  $MPR_{WT\_C\_CA}$  shall be derived instead as  $\text{MAX}(MPR_1, MPR_2)$ , where:

$MPR_1$  shall be determined from Table 6.2.2.3.1-1 if CABW ≤ 200 MHz, from Table 6.2.2.3.1-2 if CABW > 200 MHz.

$MPR_2$  shall be determined from Table 6.2.2.3.1-1 if UL  $BW_{\text{channel\_CA}} \leq 200$  MHz, from Table 6.2.2.3.1-2 if UL  $BW_{\text{channel\_CA}} > 200$  MHz.

and assume all UL CCs use the same SCS for the purpose of determination of inner and outer RB allocations in Table 6.2.2.3.1-1 and Table 6.2.2.3.1-2:

$N_{RB}$  shall be chosen as the sum of  $N_{RB}$  of all constituent UL CCs in the CA configuration.

$L_{CRB}$  shall be chosen as  $BW_{\text{alloc, RB}}$

$RB_{\text{start}}$  shall be derived as:  $RB_{\text{start\_allocatedCC}} + N_{RB\_unallocatedCC\_low}$

$RB_{\text{start\_allocatedCC}}$  is the index of the first allocated RB in the CC with allocation

$N_{RB\_unallocatedCC\_low}$  is the sum of  $N_{RB}$  in all UL CCs lower in frequency compared to the CC with allocation

When different waveform types exist across CCs, the requirement is set by the waveform type used in the configuration with the largest  $MPR_{C\_CA}$ .

For intra-band contiguous UL CA with non-contiguous RB allocations, the following rule for MPR applies:

$$MPR = \max(MPR_{C\_CA}, -10 \cdot A + [14.4])$$

Where:

$$A = N_{RB\_alloc} / N_{RB\_agg\_C}$$

$N_{RB\_alloc}$  is the total number of allocated UL RBs

$N_{RB\_agg\_C}$  is the number of the aggregated RBs within the fully allocated cumulative aggregated channel bandwidth assuming lowest SCS among all configured CCs

For intra-band non-contiguous UL CA, the following rule for MPR applies:

$$MPR = \max(MPR_{NC\_CA}, -10 \cdot A + 14.4)$$

Where:

$MPR_{NC\_CA}$  is derived from table 6.2A.2.0.2-2

**Table 6.2A.2.0.2-2:  $MPR_{NC\_CA}$  for UE power class 1**

Waveform Type	Cumulative aggregated channel bandwidth (CABW)			
	< 400 MHz	≥ 400 MHz and < 800	≥ 800 MHz and ≤ 1400	> 1400 MHz and ≤ 2400

			MHz	MHz	MHz
DFT-s-OFDM	Pi/2 BPSK	≤ 6	≤ 7.7	≤ 8.2	≤ 8.7
	QPSK	≤ 7	≤ 8.7	≤ 9.2	≤ 9.7
	16 QAM	≤ 7	≤ 8.7	≤ 9.2	≤ 9.7
	64 QAM	≤ 9.0	≤ 10.7	≤ 11.2	≤ 11.7
CP-OFDM	QPSK	≤ 7	≤ 8.7	≤ 9.2	≤ 9.7
	16 QAM	≤ 7	≤ 8.7	≤ 9.2	≤ 9.7
	64 QAM	≤ 9.0	≤ 10.7	≤ 11.2	≤ 11.7

### 6.2A.2.0.3 Maximum output power reduction for power class 2

For power class 2, MPR specified in sub-clause 6.2A.2.0.4 applies.

**Table 6.2A.2.0.3-1: (Void)**

### 6.2A.2.0.4 Maximum output power reduction for power class 3

For power class 3, MPR for intra-band contiguous UL CA with contiguous allocations within the cumulative aggregated bandwidth is denoted as  $MPR_{C\_CA}$  and is defined in Table 6.2A.2.0.4-1.

**Table 6.2A.2.0.4-1: Maximum power reduction ( $MPR_{C\_CA}$ ) for UE power class 3**

		Cumulative aggregated bandwidth configuration			
		≤ 400 MHz	> 400 MHz and < 800 MHz	≥ 800 MHz and ≤ 1400 MHz	> 1400 MHz and ≤ 2400 MHz
DFT-s-OFDM	Pi/2 BPSK	≤ 5.0 <sup>1</sup>	≤ 7.7 <sup>1</sup>	≤ 8.2	≤ 8.7
	QPSK	≤ 5.0 <sup>1</sup>	≤ 7.7 <sup>1</sup>	≤ 8.2	≤ 9.7
	16 QAM	≤ 6.5	≤ 8.7	≤ 9.3	≤ 9.7
	64 QAM	≤ 9.0	≤ 10.7	≤ 11.2	≤ 11.7
CP-OFDM	QPSK	≤ 5.0	≤ 7.5	≤ 8.0	≤ 9.7
	16 QAM	≤ 6.5	≤ 8.7	≤ 9.2	≤ 9.7
	64 QAM	≤ 9.0	≤ 10.7	≤ 11.2	≤ 11.7
NOTE 1: void.					

In case of a contiguous RB, DFT-s-BPSK or DFT-s-QPSK UL allocation in a single CC of a CA configuration with contiguous CCs, and whose cumulative aggregated BW ≤ 400 MHz,  $MPR_{C\_CA}$  shall be derived instead as  $MAX(MPR_1, MPR_2)$ , where:

$MPR_1$  shall be determined from Table 6.2.2.3.3-1 if  $CABW \leq 200$  MHz, from Table 6.2.2.3.3-2 if  $CABW > 200$  MHz.

$MPR_2$  shall be determined from Table 6.2.2.3.3-1 if  $UL\ BW_{channel\_CA} \leq 200$  MHz, from Table 6.2.2.3.3-2 if  $UL\ BW_{channel\_CA} > 200$  MHz.

and assume all UL CCs use the same SCS for the purpose of determination of inner and outer RB allocations in Table 6.2.2.3.3-1 and Table 6.2.2.3.3-2:

$N_{RB}$  shall be chosen as the sum of  $N_{RB}$  of all constituent UL CCs in the CA configuration.

$L_{CRB}$  shall be chosen as  $BW_{alloc,RB}$

$RB_{start}$  shall be derived as:  $RB_{start\_allocatedCC} + N_{RB\_unallocatedCC\_low}$

$RB_{start\_allocatedCC}$  is the index of the first allocated RB in the CC with allocation

$N_{RB\_unallocatedCC\_low}$  is the sum of  $N_{RB}$  in all UL CCs lower in frequency compared to the CC with allocation

When different waveform types exist across CCs, the requirement is set by the waveform type used in the configuration with the highest contiguous MPR.

For intra-band contiguous UL CA with non-contiguous RB allocations, the following rule for MPR applies:

$$\text{MPR} = \max(\text{MPR}_{\text{C\_CA}}, -10 \cdot A + 7.0)$$

Where:

$$A = N_{\text{RB\_alloc}} / N_{\text{RB\_agg\_C}}$$

$N_{\text{RB\_alloc}}$  is the total number of allocated UL RBs

$N_{\text{RB\_agg\_C}}$  is the number of the aggregated RBs within the fully allocated cumulative aggregated channel bandwidth assuming lowest SCS among all configured CCs

For intra-band non-contiguous UL CA, the following rule for MPR applies:

$$\text{MPR} = \max(\text{MPR}_{\text{NC\_CA}}, -8 \cdot A + 10.0)$$

Where:

$\text{MPR}_{\text{NC\_CA}}$  is derived from table 6.2A.2.4.2-1

**Table 6.2A.2.0.4-2:  $\text{MPR}_{\text{NC\_CA}}$  for UE power class 3**

		Cumulative aggregated channel bandwidth (CABW)			
		≤ 400 MHz	> 400 MHz and < 800 MHz	≥ 800 MHz and ≤ 1400 MHz	> 1400 MHz and ≤ 2400 MHz
DFT-s-OFDM	Pi/2 BPSK	≤ 5.5	≤ 7.7	≤ 8.2	≤ 8.7
	QPSK	≤ 6	≤ 7.7	≤ 8.2	≤ 8.7
	16 QAM	≤ 7	≤ 8.7	≤ 9.3	≤ 9.8
	64 QAM	≤ 9.0	≤ 10.7	≤ 11.2	≤ 11.7
CP-OFDM	QPSK	≤ 6	≤ 7.5	≤ 8.0	≤ 8.5
	16 QAM	≤ 7	≤ 8.7	≤ 9.2	≤ 9.7
	64 QAM	≤ 9.0	≤ 10.7	≤ 11.2	≤ 11.7

#### 6.2A.2.0.5 Maximum output power reduction for power class 4

For power class 4, MPR specified in sub-clause 6.2A.2.0.4 applies.

The normative reference for this requirement is TS 38.101-2 [3] clause 6.2A.2.

#### 6.2A.2.1 UE maximum output power reduction for CA (2UL CA)

**Editor's note: The following aspects are either missing or not yet determined:**

- The UPLF test mode is applicable to UEs Release 16 and forward.
- This test case is incomplete for Power classes 1, 2, 4 Release 15.

For a transition period until RAN#99, the stability and repeatability of test procedure with PHR (variant b) for Rel-15 UEs is under evaluation.

- Whether additional check is needed in the test procedure to ensure UE continues transmissions on the SCell is FFS
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.
- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 400MHz and intra-band non-contiguous CA are TBD.
- The test points for higher bandwidth classes with testability problem need an update to decrease the UL bandwidth until they become testable.

- Test points with more than 3 DL CCs for PC1, 2, 4 are pending removal as already done for PC3
- Following aspects are pending RAN4
  - Minimum requirements for cumulative aggregated bandwidth >=800MHz are within brackets

6.2A.2.1.1 Test purpose

The number of RB identified in 6.2.2.3 is based on meeting the requirements for the maximum power reduction (MPR) due to Cubic Metric (CM).

6.2A.2.1.2 Test applicability

The requirements of this test apply to all types of NR UE release 15 and forward supporting 2UL CA.

6.2A.2.1.3 Minimum conformance requirements

The normative reference for this requirement is TS 38.101-2 [3] clause 6.2A.2.0.

6.2A.2.1.4 Test description

6.2A.2.1.4.1 Initial conditions

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, and CC combinations based on NR operating bands specified in clause 5.5A. All of these configurations shall be tested with applicable test parameters for each CA configuration and subcarrier spacing, are shown in Table 6.2A.2.1.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCCH before measurement are specified in Annex C.2.

**Table 6.2A.2.1.4.1-1: Intra-band Contiguous UL CA Test Configuration Table (Power Class 1, MPR<sub>narrow</sub>)**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes				Refer to "Test frequency" column		
Test CC Combination setting (aggregated BW of the CA configuration) as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE				Highest aggregated channel bandwidth of the CA configuration		
Test SCS as specified in Table 5.3.5-1				120 kHz		
Test Parameters						
Test ID	CC & Mapping (NOTE 2)	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation (NOTE 1)
Default Test Settings for a CA_nXB, CA_nXD, CA_nXG, CA_nXO Configuration						
1	PCC/CC1	Default	Low	-	CP-OFDM 64QAM	Outer_1RB_Left
	SCC/CC2		Low		-	-
2	PCC/CC1		High		CP-OFDM 64QAM	Outer_1RB_Right
	SCC/CC2		High		-	-
3	PCC/CC1		Low		CP-OFDM 64QAM	7@0
	SCC/CC2		Low		-	-
4	PCC/CC1	High	CP-OFDM 64QAM	7@NRB-7		

	SCC/CC2		High		-	-
<b>Default Test Settings for a CA_nX(D-G)_UL_nXD, CA_nX(D-G)_UL_nXG, CA_nX(D-O)_UL_nXD, CA_nX(D-O)_UL_nXO Configuration</b>						
1	PCC/CC1	Default	Low	-	CP-OFDM 64QAM	Outer_1RB_Left
	SCC1/CC2		Low		-	-
	Wgap		Max Wgap		N/A	N/A
	SCC2/CC3		Low		N/A	N/A
	SCC3/CC4		Low		N/A	N/A
2	PCC/CC1	Default	High	-	CP-OFDM 64QAM	Outer_1RB_Right
	SCC1/CC2		High		-	-
	Wgap		Max Wgap		N/A	N/A
	SCC2/CC3		High		N/A	N/A
	SCC3/CC4		High		N/A	N/A
3	PCC/CC1	Default	Low	-	CP-OFDM 64QAM	7@0
	SCC1/CC2		Low		-	-
	Wgap		Max Wgap		N/A	N/A
	SCC2/CC3		Low		N/A	N/A
	SCC3/CC4		Low		N/A	N/A
4	PCC/CC1	Default	High	-	CP-OFDM 64QAM	7@N <sub>RB</sub> -7
	SCC1/CC2		High		-	-
	Wgap		Max Wgap		N/A	N/A
	SCC2/CC3		High		N/A	N/A
	SCC3/CC4		High		N/A	N/A
<b>Default Test Settings for a CA_nX(D-H)_UL_nXD, CA_nX(D-P)_UL_nXD, CA_nX(E-O)_UL_nXO Configuration</b>						
1	PCC/CC1	Default	Low	-	CP-OFDM 64QAM	Outer_1RB_Left
	SCC1/CC2		Low		-	-
	Wgap		Max Wgap		N/A	N/A
	SCC2/CC3		Low		N/A	N/A
	SCC3/CC4		Low		N/A	N/A
2	PCC/CC1	Default	High	-	CP-OFDM 64QAM	Outer_1RB_Right
	SCC1/CC2		High		-	-
	Wgap		Max Wgap		N/A	N/A
	SCC2/CC3		High		N/A	N/A
	SCC3/CC4		High		N/A	N/A
3	PCC/CC1	Default	Low	-	CP-OFDM 64QAM	7@0
	SCC1/CC2		Low		-	-
	Wgap		Max Wgap		N/A	N/A
	SCC2/CC3		Low		N/A	N/A
	SCC3/CC4		Low		N/A	N/A
4	PCC/CC1	Default	High	-	CP-OFDM 64QAM	7@N <sub>RB</sub> -7
	SCC1/CC2		High		-	-
	Wgap		Max Wgap		N/A	N/A
	SCC2/CC3		High		N/A	N/A
	SCC3/CC4		High		N/A	N/A
<b>Default Test Settings for a CA_nX(D-I)_UL_nXD, CA_nX(D-Q)_UL_nXD, CA_nX(G-I)_UL_nXG Configuration</b>						
1	PCC/CC1	Default	Low	-	CP-OFDM 64QAM	Outer_1RB_Left
	SCC1/CC2		Low		-	-
	Wgap		Max Wgap		N/A	N/A
	SCC2/CC3		Low		N/A	N/A
	SCC3/CC4		Low		N/A	N/A
	SCC4/CC5		Low		N/A	N/A
2	PCC/CC1	Default	High	-	CP-OFDM	Outer_1RB_Right



	SCC1/CC2	High	64QAM	-
	Wgap	Max Wgap	-	-
	SCC2/CC3	High	N/A	N/A
	SCC3/CC4	High	N/A	N/A
	SCC4/CC5	High	N/A	N/A
	SCC5/CC6	High	N/A	N/A
3	PCC/CC1	Low	CP-OFDM 64QAM	7@0
	SCC1/CC2	Low	-	-
	Wgap	Max Wgap	N/A	N/A
	SCC2/CC3	Low	N/A	N/A
	SCC3/CC4	Low	N/A	N/A
	SCC4/CC5	Low	N/A	N/A
4	PCC/CC1	High	CP-OFDM 64QAM	7@N <sub>RB</sub> -7
	SCC1/CC2	High	-	-
	Wgap	Max Wgap	N/A	N/A
	SCC2/CC3	High	N/A	N/A
	SCC3/CC4	High	N/A	N/A
	SCC4/CC5	High	N/A	N/A

NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-2.  
 NOTE 2: PCC/CC<sub>i</sub> and SCC/CC<sub>j</sub> means PCC is on component carrier CC<sub>i</sub> and SCC is on component carrier CC<sub>j</sub>, with CC<sub>i</sub> or CC<sub>j</sub> frequencies defined in TS38.508-1 [10].

**Table 6.2A.2.1.4.1-2: Intra-band Contiguous UL CA Test Configuration Table (Power Class 1, single CC MPR requirement)**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal			
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes			Low range, High range			
Test CC Combination setting (aggregated BW of the CA configuration) as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE			Highest aggregated channel bandwidth of the CA configuration			
Test SCS as specified in Table 5.3.5-1			120 kHz			
Test Parameters						
Test ID	CC & Mapping (NOTE 2)	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation
Default Test Settings for a CA_nXG, CA_nXO Configuration (Cumulative aggregated BWchannel <= 200MHz)						
1	PCC/CC1	Default	Default	-	DFT-s-OFDM PI/2 BPSK	Outer_Full
	SCC/CC2				-	-
2	PCC/CC1	Default	Default	-	DFT-s-OFDM QPSK	Inner_Full_Region1
	SCC/CC2				-	-
Default Test Settings for a CA_nXD Configuration (Cumulative aggregated BWchannel <= 400MHz)						
1	PCC/CC1	Default	Default	-	DFT-s-OFDM PI/2 BPSK	Outer_Full
	SCC/CC2				-	-
2	PCC/CC1	Default	Default	-	DFT-s-OFDM PI/2 BPSK	Inner_Full_Region1
	SCC/CC2				-	-
3	PCC/CC1	Default	Default	-	DFT-s-OFDM QPSK	Inner_Full_Region1
	SCC/CC2				-	-
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-2. NOTE 2: PCC/CC <sub>i</sub> and SCC/CC <sub>j</sub> means PCC is on component carrier CC <sub>i</sub> and SCC is on component carrier CC <sub>j</sub> , with CC <sub>i</sub> or CC <sub>j</sub> frequencies defined in TS38.508-1 [10]. NOTE 3: DFT-s-OFDM PI/2 BPSK test applies only for UEs which supports half Pi BPSK in FR1.						

**Table 6.2A.2.1.4.1-3: Intra-band Contiguous UL CA Test Configuration Table (Power Class 1, MPR<sub>C,CA</sub>)**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 and 4.3.1.2.4 for different CA bandwidth classes				For intra-band contiguous CA: Mid range. For intra-band non-contiguous CA: FFS.		
Test CC Combination setting (aggregated BW of the CA configuration) as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 and 4.3.1.2.4 for the CA Configuration across bandwidth combination sets supported by the UE				Highest aggregated channel bandwidth of the CA configuration		
Test SCS as specified in Table 5.3.5-1				120 kHz		
Test Parameters						
Test ID	CC & Mapping (NOTE 2)	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation
Default Test Settings for a CA_nXB, CA_nXC_UL_nXB Configuration (800MHz <= Cumulative aggregated BWchannel <= 1400MHz)						
1	PCC/CC1	Default	Default	-	DFT-s-OFDM Pi/2 BPSK	Outer_Full
	SCC/CC2				DFT-s-OFDM Pi/2 BPSK	Outer_Full
2	PCC/CC1	Default	Default	-	DFT-s-OFDM QPSK	Outer_Full
	SCC/CC2				DFT-s-OFDM QPSK	Outer_Full
3	PCC/CC1	Default	Default	-	DFT-s-OFDM 16QAM	Outer_Full
	SCC/CC2				DFT-s-OFDM 16QAM	Outer_Full
4	PCC/CC1	Default	Default	-	CP-OFDM 16QAM	Outer_Full
	SCC/CC2				CP-OFDM 16QAM	Outer_Full
5	PCC/CC1	Default	Default	-	CP-OFDM 64QAM	Outer_Full
	SCC/CC2				CP-OFDM 64QAM	Outer_Full
Default Test Settings for a CA_nXD Configuration (400MHz <= Cumulative aggregated BWchannel < 800MHz)						
1	PCC/CC1	Default	Default	-	DFT-s-OFDM Pi/2 BPSK	Outer_Full
	SCC/CC2				DFT-s-OFDM Pi/2 BPSK	Outer_Full
2	PCC/CC1	Default	Default	-	CP-OFDM 16QAM	Outer_Full
	SCC/CC2				CP-OFDM 16QAM	Outer_Full
3	PCC/CC1	Default	Default	-	CP-OFDM 64QAM	Outer_Full
	SCC/CC2				CP-OFDM 64QAM	Outer_Full
Default Test Settings for a CA_nXB Configuration (400MHz <= Cumulative aggregated BWchannel < 800MHz)						
1	PCC/CC1	200MHz	Default	-	DFT-s-OFDM Pi/2 BPSK	Outer_Full
	SCC/CC2	400MHz			DFT-s-OFDM Pi/2 BPSK	Outer_Full
2	PCC/CC1	200MHz	Default	-	CP-OFDM 16QAM	Outer_Full
	SCC/CC2	400MHz			CP-OFDM 16QAM	Outer_Full
3	PCC/CC1	200MHz	Default	-	CP-OFDM 64QAM	Outer_Full
	SCC/CC2	400MHz			CP-OFDM 64QAM	Outer_Full

Default Test Settings for a CA_nXG, CA_nXO Configuration (Cumulative aggregated BWchannel < 400MHz)						
1	PCC/CC1	Default	Default	-	DFT-s-OFDM Pi/2 BPSK	Outer_Full
	SCC/CC2				DFT-s-OFDM Pi/2 BPSK	Outer_Full
2	PCC/CC1	Default	Default	-	CP-OFDM 16QAM	Outer_Full
	SCC/CC2				CP-OFDM 16QAM	Outer_Full
3	PCC/CC1	Default	Default	-	CP-OFDM 64QAM	Outer_Full
	SCC/CC2				CP-OFDM 64QAM	Outer_Full
Default Test Settings for a CA_nXD Configuration (Cumulative aggregated BWchannel < 400MHz)						
1	PCC/CC1	100MHz	Default	-	DFT-s-OFDM Pi/2 BPSK	Outer_Full
	SCC/CC2	200MHz			DFT-s-OFDM Pi/2 BPSK	Outer_Full
2	PCC/CC1	100MHz	Default	-	CP-OFDM 16QAM	Outer_Full
	SCC/CC2	200MHz			CP-OFDM 16QAM	Outer_Full
3	PCC/CC1	100MHz	Default	-	CP-OFDM 64QAM	Outer_Full
	SCC/CC2	200MHz			CP-OFDM 64QAM	Outer_Full
Default Test Settings for a CA_nX(D-G)_UL_nXD, CA_nX(D-G)_UL_nXG, CA_nX(D-O)_UL_nXD, CA_nX(D-O)_UL_nXO Configuration (800MHz <= Cumulative aggregated BWchannel <= 1400MHz)						
1	PCC/CC1	Default	Default	-	DFT-s-OFDM Pi/2 BPSK	Outer_Full
	SCC1/CC2				DFT-s-OFDM Pi/2 BPSK	Outer_Full
	Wgap				N/A	N/A
	SCC2/CC3				N/A	N/A
	SCC3/CC4				N/A	N/A
2	PCC/CC1	Default	Default	-	DFT-s-OFDM QPSK	Outer_Full
	SCC1/CC2				DFT-s-OFDM QPSK	Outer_Full
	Wgap				N/A	N/A
	SCC2/CC3				N/A	N/A
	SCC3/CC4				N/A	N/A
3	PCC/CC1	Default	Default	-	DFT-s-OFDM 16QAM	Outer_Full
	SCC1/CC2				DFT-s-OFDM 16QAM	Outer_Full
	Wgap				N/A	N/A
	SCC2/CC3				N/A	N/A
	SCC3/CC4				N/A	N/A
4	PCC/CC1	Default	Default	-	CP-OFDM 16QAM	Outer_Full
	SCC1/CC2				CP-OFDM 16QAM	Outer_Full
	Wgap				N/A	N/A
	SCC2/CC3				N/A	N/A
	SCC3/CC4				N/A	N/A
5	PCC/CC1	Default	Default	-	CP-OFDM 64QAM	Outer_Full
	SCC1/CC2				CP-OFDM 64QAM	Outer_Full
	Wgap				N/A	N/A
	SCC2/CC3				N/A	N/A
	SCC3/CC4				N/A	N/A
Default Test Settings for a CA_nX(D-H)_UL_nXD, CA_nX(D-P)_UL_nXD, CA_nX(E-O)_UL_nXO Configuration (800MHz <= Cumulative aggregated BWchannel <= 1400MHz)						
1	PCC/CC1	Default	Default	-	DFT-s-OFDM	Outer_Full

	SCC1/CC2				Pi/2 BPSK	
	Wgap				DFT-s-OFDM	Outer_Full
	SCC2/CC3				Pi/2 BPSK	N/A
	SCC3/CC4				N/A	N/A
	SCC4/CC5				N/A	N/A
2	PCC/CC1				DFT-s-OFDM	Outer_Full
	SCC1/CC2				QPSK	
	Wgap				DFT-s-OFDM	Outer_Full
	SCC2/CC3				QPSK	N/A
	SCC3/CC4				N/A	N/A
	SCC4/CC5				N/A	N/A
3	PCC/CC1				DFT-s-OFDM	Outer_Full
	SCC1/CC2				16QAM	
	Wgap				DFT-s-OFDM	Outer_Full
	SCC2/CC3				16QAM	N/A
	SCC3/CC4				N/A	N/A
	SCC4/CC5				N/A	N/A
4	PCC/CC1				CP-OFDM	Outer_Full
	SCC1/CC2				16QAM	
	Wgap				CP-OFDM	Outer_Full
	SCC2/CC3				16QAM	N/A
	SCC3/CC4				N/A	N/A
	SCC4/CC5				N/A	N/A
5	PCC/CC1				CP-OFDM	Outer_Full
	SCC1/CC2				64QAM	
	Wgap				CP-OFDM	Outer_Full
	SCC2/CC3				64QAM	N/A
	SCC3/CC4				N/A	N/A
	SCC4/CC5				N/A	N/A
<b>Default Test Settings for a CA_nX(D-I)_UL_nXD, CA_nX(D-Q)_UL_nXD, CA_nX(G-I)_UL_nXG Configuration (800MHz &lt;= Cumulative aggregated BWchannel &lt;= 1400MHz)</b>						
1	PCC/CC1	Default	Default	-	DFT-s-OFDM	Outer_Full
	SCC1/CC2				Pi/2 BPSK	
	Wgap				DFT-s-OFDM	Outer_Full
	SCC2/CC3				Pi/2 BPSK	
	SCC3/CC4				N/A	N/A
	SCC4/CC5				N/A	N/A
2	PCC/CC1				DFT-s-OFDM	Outer_Full
	SCC1/CC2				QPSK	
	Wgap				DFT-s-OFDM	Outer_Full
	SCC2/CC3				QPSK	
	SCC3/CC4				N/A	N/A
	SCC4/CC5				N/A	N/A
3	PCC/CC1				DFT-s-OFDM	Outer_Full
	SCC1/CC2				16QAM	
	Wgap				DFT-s-OFDM	Outer_Full
	SCC2/CC3				16QAM	
	SCC3/CC4				N/A	N/A

4	SCC4/CC5				N/A	N/A
	SCC5/CC6				N/A	N/A
	PCC/CC1				CP-OFDM 16QAM	Outer_Full
	SCC1/CC2				CP-OFDM 16QAM	Outer_Full
	Wgap				N/A	N/A
	SCC2/CC3				N/A	N/A
	SCC3/CC4				N/A	N/A
	SCC4/CC5				N/A	N/A
5	SCC5/CC6				N/A	N/A
	PCC/CC1				CP-OFDM 64QAM	Outer_Full
	SCC1/CC2				CP-OFDM 64QAM	Outer_Full
	Wgap				N/A	N/A
	SCC2/CC3				N/A	N/A
	SCC3/CC4				N/A	N/A
	SCC4/CC5				N/A	N/A
	SCC5/CC6				N/A	N/A
<b>Default Test Settings for a CA_nX(D-G)_UL_nXD, CA_nX(D-O)_UL_nXD Configuration (400MHz &lt;= Cumulative aggregated BWchannel &lt;800MHz)</b>						
1	PCC/CC1	200MHz	Default	-	DFT-s-OFDM Pi/2 BPSK	Outer_Full
	SCC1/CC2	200MHz			DFT-s-OFDM Pi/2 BPSK	Outer_Full
	Wgap	190MHz			N/A	N/A
	SCC2/CC3	100MHz			N/A	N/A
	SCC3/CC4	100MHz			N/A	N/A
2	PCC/CC1	200MHz			CP-OFDM 16QAM	Outer_Full
	SCC1/CC2	200MHz			CP-OFDM 16QAM	Outer_Full
	Wgap	190MHz			N/A	N/A
	SCC2/CC3	100MHz			N/A	N/A
	SCC3/CC4	100MHz			N/A	N/A
3	PCC/CC1	200MHz			CP-OFDM 64QAM	Outer_Full
	SCC1/CC2	200MHz			CP-OFDM 64QAM	Outer_Full
	Wgap	190MHz			N/A	N/A
	SCC2/CC3	100MHz			N/A	N/A
	SCC3/CC4	100MHz			N/A	N/A
<b>Default Test Settings for a CA_nX(D-G)_UL_nXG, CA_nX(D-O)_UL_nXO Configuration (400MHz &lt;= Cumulative aggregated BWchannel &lt;800MHz)</b>						
1	PCC/CC1	100MHz	Default	-	DFT-s-OFDM Pi/2 BPSK	Outer_Full
	SCC1/CC2	100MHz			DFT-s-OFDM Pi/2 BPSK	Outer_Full
	Wgap	190MHz			N/A	N/A
	SCC2/CC3	200MHz			N/A	N/A
	SCC3/CC4	200MHz			N/A	N/A
2	PCC/CC1	100MHz			CP-OFDM 16QAM	Outer_Full
	SCC1/CC2	100MHz			CP-OFDM 16QAM	Outer_Full
	Wgap	190MHz			N/A	N/A
	SCC2/CC3	200MHz			N/A	N/A
	SCC3/CC4	200MHz			N/A	N/A
3	PCC/CC1	100MHz			CP-OFDM 64QAM	Outer_Full
	SCC1/CC2	100MHz			CP-OFDM 64QAM	Outer_Full
	Wgap	190MHz			N/A	N/A
	SCC2/CC3	200MHz			N/A	N/A
	SCC3/CC4	200MHz			N/A	N/A

Default Test Settings for a CA_nX(D-H)_UL_nXD, CA_nX(D-P)_UL_nXD, Configuration (400MHz <= Cumulative aggregated BWchannel < 800MHz)						
1	PCC/CC1	200MHz	Default	-	DFT-s-OFDM Pi/2 BPSK	Outer_Full
	SCC1/CC2	200MHz			DFT-s-OFDM Pi/2 BPSK	Outer_Full
	Wgap	90MHz			N/A	N/A
	SCC2/CC3	100MHz			N/A	N/A
	SCC3/CC4	100MHz			N/A	N/A
	SCC4/CC5	100MHz			N/A	N/A
2	PCC/CC1	200MHz	Default	-	CP-OFDM 16QAM	Outer_Full
	SCC1/CC2	200MHz			CP-OFDM 16QAM	Outer_Full
	Wgap	90MHz			N/A	N/A
	SCC2/CC3	100MHz			N/A	N/A
	SCC3/CC4	100MHz			N/A	N/A
	SCC4/CC5	100MHz			N/A	N/A
3	PCC/CC1	200MHz	Default	-	CP-OFDM 64QAM	Outer_Full
	SCC1/CC2	200MHz			CP-OFDM 64QAM	Outer_Full
	Wgap	90MHz			N/A	N/A
	SCC2/CC3	100MHz			N/A	N/A
	SCC3/CC4	100MHz			N/A	N/A
	SCC4/CC5	100MHz			N/A	N/A
Default Test Settings for a CA_nX(O-E)_UL_nXO Configuration (400MHz <= Cumulative aggregated BWchannel < 800MHz)						
1	PCC/CC1	100MHz	Default	-	DFT-s-OFDM Pi/2 BPSK	Outer_Full
	SCC1/CC2	100MHz			DFT-s-OFDM Pi/2 BPSK	Outer_Full
	Wgap	90MHz			N/A	N/A
	SCC2/CC3	100MHz			N/A	N/A
	SCC3/CC4	200MHz			N/A	N/A
	SCC4/CC5	200MHz			N/A	N/A
2	PCC/CC1	100MHz	Default	-	CP-OFDM 16QAM	Outer_Full
	SCC1/CC2	100MHz			CP-OFDM 16QAM	Outer_Full
	Wgap	90MHz			N/A	N/A
	SCC2/CC3	100MHz			N/A	N/A
	SCC3/CC4	200MHz			N/A	N/A
	SCC4/CC5	200MHz			N/A	N/A
3	PCC/CC1	100MHz	Default	-	CP-OFDM 64QAM	Outer_Full
	SCC1/CC2	100MHz			CP-OFDM 64QAM	Outer_Full
	Wgap	90MHz			N/A	N/A
	SCC2/CC3	100MHz			N/A	N/A
	SCC3/CC4	200MHz			N/A	N/A
	SCC4/CC5	200MHz			N/A	N/A
Default Test Settings for a CA_nX(D-I)_UL_nXD, CA_nX(D-Q)_UL_nXD Configuration (400MHz <= Cumulative aggregated BWchannel < 800MHz)						
1	PCC/CC1	100MHz	Default	-	DFT-s-OFDM Pi/2 BPSK	Outer_Full
	SCC1/CC2	200MHz			DFT-s-OFDM Pi/2 BPSK	Outer_Full
	Wgap	90MHz			N/A	N/A
	SCC2/CC3	100MHz			N/A	N/A
	SCC3/CC4	100MHz			N/A	N/A
	SCC4/CC5	100MHz			N/A	N/A
2	PCC/CC1	100MHz	Default	-	CP-OFDM 16QAM	Outer_Full
	SCC1/CC2	200MHz			CP-OFDM	Outer_Full

					16QAM	
	Wgap	90MHz			N/A	N/A
	SCC2/CC3	100MHz			N/A	N/A
	SCC3/CC4	100MHz			N/A	N/A
	SCC4/CC5	100MHz			N/A	N/A
	SCC5/CC6	100MHz			N/A	N/A
3	PCC/CC1	100MHz			CP-OFDM 64QAM	Outer_Full
	SCC1/CC2	200MHz			CP-OFDM 64QAM	Outer_Full
	Wgap	90MHz			N/A	N/A
	SCC2/CC3	100MHz			N/A	N/A
	SCC3/CC4	100MHz			N/A	N/A
	SCC4/CC5	100MHz			N/A	N/A
	SCC5/CC6	100MHz			N/A	N/A
<b>Default Test Settings for a CA_nX(G-I)_UL_nXG Configuration (400MHz &lt;= Cumulative aggregated BWchannel &lt; 800MHz)</b>						
1	PCC/CC1	100MHz	Default	-	DFT-s-OFDM Pi/2 BPSK	Outer_Full
	SCC1/CC2	100MHz			DFT-s-OFDM Pi/2 BPSK	Outer_Full
	Wgap	190MHz			N/A	N/A
	SCC2/CC3	100MHz			N/A	N/A
	SCC3/CC4	100MHz			N/A	N/A
	SCC4/CC5	100MHz			N/A	N/A
	SCC5/CC6	100MHz			N/A	N/A
2	PCC/CC1	100MHz			CP-OFDM 16QAM	Outer_Full
	SCC1/CC2	100MHz			CP-OFDM 16QAM	Outer_Full
	Wgap	190MHz			N/A	N/A
	SCC2/CC3	100MHz			N/A	N/A
	SCC3/CC4	100MHz			N/A	N/A
	SCC4/CC5	100MHz			N/A	N/A
	SCC5/CC6	100MHz			N/A	N/A
3	PCC/CC1	100MHz			CP-OFDM 64QAM	Outer_Full
	SCC1/CC2	100MHz			CP-OFDM 64QAM	Outer_Full
	Wgap	190MHz			N/A	N/A
	SCC2/CC3	100MHz			N/A	N/A
	SCC3/CC4	100MHz			N/A	N/A
	SCC4/CC5	100MHz			N/A	N/A
	SCC5/CC6	100MHz			N/A	N/A
<b>Default Test Settings for a CA_nX(D-O)_UL_nXD Configuration (Cumulative aggregated BWchannel &lt;400MHz)</b>						
1	PCC/CC1	50MHz	Default	-	DFT-s-OFDM Pi/2 BPSK	Outer_Full
	SCC1/CC2	200MHz			DFT-s-OFDM Pi/2 BPSK	Outer_Full
	Wgap	40MHz			N/A	N/A
	SCC2/CC3	50MHz			N/A	N/A
	SCC3/CC4	50MHz			N/A	N/A
2	PCC/CC1	50MHz			CP-OFDM 16QAM	Outer_Full
	SCC1/CC2	200MHz			CP-OFDM 16QAM	Outer_Full
	Wgap	40MHz			N/A	N/A
	SCC2/CC3	50MHz			N/A	N/A
	SCC3/CC4	50MHz			N/A	N/A
3	PCC/CC1	50MHz			CP-OFDM 64QAM	Outer_Full
	SCC1/CC2	200MHz			CP-OFDM 64QAM	Outer_Full
	Wgap	40MHz			N/A	N/A
	SCC2/CC3	50MHz			N/A	N/A
	SCC3/CC4	50MHz			N/A	N/A

Default Test Settings for a CA_nX(D-O)_UL_nXO Configuration (Cumulative aggregated BWchannel <400MHz)						
1	PCC/CC1	50MHz	Default	-	N/A	N/A
	SCC1/CC2	200MHz			N/A	N/A
	Wgap	40MHz			N/A	N/A
	SCC2/CC3	50MHz			DFT-s-OFDM Pi/2 BPSK	Outer_Full
	SCC3/CC4	50MHz			DFT-s-OFDM Pi/2 BPSK	Outer_Full
2	PCC/CC1	50MHz			N/A	N/A
	SCC1/CC2	200MHz			N/A	N/A
	Wgap	40MHz			N/A	N/A
	SCC2/CC3	50MHz			CP-OFDM 16QAM	Outer_Full
	SCC3/CC4	50MHz			CP-OFDM 16QAM	Outer_Full
3	PCC/CC1	50MHz			N/A	N/A
	SCC1/CC2	200MHz			N/A	N/A
	Wgap	40MHz			N/A	N/A
	SCC2/CC3	50MHz			CP-OFDM 64QAM	Outer_Full
	SCC3/CC4	50MHz			CP-OFDM 64QAM	Outer_Full

NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-2.  
 NOTE 2: PCC/CCi and SCC/CCj means PCC is on component carrier CCi and SCC is on component carrier CCj, with CCi or CCj frequencies defined in TS38.508-1 [10].

**Table 6.2A.2.1.4.1-4: Intra-band Contiguous UL CA Test Configuration Table (Power Class 1, Non-contiguous allocation)**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 and 4.3.1.2.4 for different CA bandwidth classes				For intra-band contiguous CA: Mid range. For intra-band non-contiguous CA: FFS.		
Test CC Combination setting (aggregated BW of the CA configuration) as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 and 4.3.1.2.4 for the CA Configuration across bandwidth combination sets supported by the UE				Highest aggregated channel bandwidth of the CA configuration		
Test SCS as specified in Table 5.3.5-1				120 kHz		
Test Parameters						
Test ID	CC & Mapping (NOTE 2)	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation
Default Test Settings for a CA_nXB, CA_nXD, CA_XG, CA_nXO Configuration						
1	PCC/CC1	Default	Default	-	CP-OFDM 64QAM	Outer_1RB_Left
	SCC/CC2				CP-OFDM 64QAM	Outer_1RB_Right
2	PCC/CC1				DFT-s-OFDM Pi/2 BPSK	[Outer_0.9_Left]
	SCC/CC2				DFT-s-OFDM Pi/2 BPSK	[Outer_0.9_Right]
3	PCC/CC1				DFT-s-OFDM Pi/2 QPSK	[Outer_0.9_Left]
	SCC/CC2				DFT-s-OFDM Pi/2 QPSK	[Outer_0.9_Right]
Default Test Settings for a CA_nX(D-G), CA_nX(D-O) Configuration						
1	PCC/CC1	Default	Default	-	DFT-s-OFDM QPSK	Outer_1RB_Left
	SCC1/CC2				DFT-s-OFDM QPSK	Outer_1RB_Right
	Wgap				N/A	N/A
	SCC2/CC3				N/A	N/A
	SCC3/CC4				N/A	N/A
2	PCC/CC1	DFT-s-OFDM Pi/2 BPSK	[Outer_0.9_Left]			
	SCC1/CC2	DFT-s-OFDM Pi/2 BPSK	[Outer_0.9_Right]			
	Wgap	N/A	N/A			



3	SCC2/CC3			N/A	N/A
	SCC3/CC4			N/A	N/A
	PCC/CC1			DFT-s-OFDM Pi/2 QPSK	[Outer_0.9_Left]
	SCC1/CC2			DFT-s-OFDM Pi/2 QPSK	[Outer_0.9_Right]
	Wgap			N/A	N/A
	SCC2/CC3			N/A	N/A
	SCC3/CC4			N/A	N/A
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-2.					
NOTE 2: PCC/CCi and SCC/CCj means PCC is on component carrier CCi and SCC is on component carrier CCj, with CCi or CCj frequencies defined in TS38.508-1 [10].					

**Table 6.2A.2.1.4.1-5: Intra-band Contiguous UL CA Test Configuration Table (Power Class 2, 3 and 4, single CC MPR requirement)**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes				Low range, High range		
Test CC Combination setting (aggregated BW of the CA configuration) as specified in for the CA Configuration across bandwidth combination sets supported by the UE				Highest aggregated channel bandwidth of the CA configuration		
Test SCS as specified in Table 5.3.5-1				120 kHz		
Test Parameters						
Test ID	CC & Mapping (NOTE 2)	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation
Default Test Settings for a CA_nXG, CA_nXO Configuration (Cumulative aggregated BWchannel <= 200MHz)						
1	PCC/CC1	Default	Default	-	DFT-s-OFDM QPSK	Inner_Full
	SCC/CC2				-	-
2	PCC/CC1	Default	Default	-	DFT-s-OFDM QPSK	Outer_Full
	SCC/CC2				-	-
Default Test Settings for a CA_nXD Configuration (Cumulative aggregated BWchannel <= 400MHz)						
1	PCC/CC1	Default	Default	-	DFT-s-OFDM QPSK	Inner_Full
	SCC/CC2				-	-
2	PCC/CC1	Default	Default	-	DFT-s-OFDM QPSK	Outer_Full
	SCC/CC2				-	-
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1.						
NOTE 2: PCC/CCi and SCC/CCj means PCC is on component carrier CCi and SCC is on component carrier CCj, with CCi or CCj frequencies defined in TS38.508-1 [10].						

**Table 6.2A.2.1.4.1-6: Intra-band Contiguous UL CA Test Configuration Table (Power Class 2, 3 and 4, MPR<sub>CA</sub>)**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 and 4.3.1.2.4 for different CA bandwidth classes				For intra-band contiguous CA: Mid range. For intra-band non-contiguous CA: FFS		
Test CC Combination setting (aggregated BW of the CA configuration) as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 and 4.3.1.2.4 for the CA Configuration across bandwidth combination sets supported by the UE				Highest aggregated channel bandwidth of the CA configuration		
Test SCS as specified in Table 5.3.5-1				120 kHz		
Test Parameters						
Test ID	CC & Mapping (NOTE 2)	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation
Default Test Settings for a CA_nXB, nXC_UL_nXB Configuration (800MHz <= Cumulative aggregated BWchannel <= 1400MHz)						
1	PCC/CC1	Default	Default	-	DFT-s-OFDM QPSK	Outer_Full
	SCC/CC2				DFT-s-OFDM	Outer_Full

2	PCC/CC1				QPSK	Outer_Full
	SCC/CC2				DFT-s-OFDM 16QAM	
3	PCC/CC1				DFT-s-OFDM 16QAM	Outer_Full
	SCC/CC2				CP-OFDM QPSK	
4	PCC/CC1				CP-OFDM QPSK	Outer_Full
	SCC/CC2				CP-OFDM 16QAM	
5	PCC/CC1				CP-OFDM 64QAM	Outer_Full
	SCC/CC2				CP-OFDM 64QAM	
<b>Default Test Settings for a CA_nXD Configuration (400MHz &lt;= Cumulative aggregated BWchannel &lt; 800MHz)</b>						
1	PCC/CC1	Default	Default	-	DFT-s-OFDM QPSK	Outer_Full
	SCC/CC2				DFT-s-OFDM QPSK	
2	PCC/CC1				CP-OFDM QPSK	Outer_Full
	SCC/CC2				CP-OFDM QPSK	
3	PCC/CC1				CP-OFDM 16QAM	Outer_Full
	SCC/CC2				CP-OFDM 16QAM	
4	PCC/CC1				CP-OFDM 64QAM	Outer_Full
	SCC/CC2				CP-OFDM 64QAM	
<b>Default Test Settings for a CA_nXB Configuration (400MHz &lt;= Cumulative aggregated BWchannel &lt; 800MHz)</b>						
1	PCC/CC1	200MHz	Default	-	DFT-s-OFDM QPSK	Outer_Full
	SCC/CC2	400MHz			DFT-s-OFDM QPSK	
2	PCC/CC1	200MHz			CP-OFDM QPSK	Outer_Full
	SCC/CC2	400MHz			CP-OFDM QPSK	
3	PCC/CC1	200MHz			CP-OFDM 16QAM	Outer_Full
	SCC/CC2	400MHz			CP-OFDM 16QAM	
4	PCC/CC1	200MHz			CP-OFDM 64QAM	Outer_Full
	SCC/CC2	400MHz			CP-OFDM 64QAM	
<b>Default Test Settings for a CA_nXG, CA_nXO Configuration (Cumulative aggregated BWchannel &lt; 400MHz)</b>						
1	PCC/CC1	Default	Default	-	CP-OFDM QPSK	Outer_Full
	SCC/CC2				CP-OFDM QPSK	
2	PCC/CC1				CP-OFDM 16QAM	Outer_Full
	SCC/CC2				CP-OFDM 16QAM	
3	PCC/CC1				CP-OFDM 64QAM	Outer_Full
	SCC/CC2				CP-OFDM 64QAM	
<b>Default Test Settings for a CA_nXD Configuration (Cumulative aggregated BWchannel &lt; 400MHz)</b>						
1	PCC/CC1	100MHz	Default	-	CP-OFDM QPSK	Outer_Full

	SCC/CC2	200MHz			CP-OFDM QPSK	Outer_Full
2	PCC/CC1	100MHz			CP-OFDM 16QAM	Outer_Full
	SCC/CC2	200MHz			CP-OFDM 16QAM	Outer_Full
3	PCC/CC1	100MHz			CP-OFDM 64QAM	Outer_Full
	SCC/CC2	200MHz			CP-OFDM 64QAM	Outer_Full
<b>Default Test Settings for a CA_nX(D-A) )_UL_nXD, CA_nX(A-G)_UL_nXG, CA_nX(A-O)_UL_nXO Configuration (800MHz &lt;= Cumulative aggregated BWchannel &lt;= 1400MHz)</b>						
1	PCC/CC1	Default	Default	-	DFT-s-OFDM QPSK	Outer_Full
	SCC1/CC2				DFT-s-OFDM QPSK	Outer_Full
	Wgap				N/A	N/A
	SCC2/CC3				N/A	N/A
2	PCC/CC1				DFT-s-OFDM 16QAM	Outer_Full
	SCC1/CC2				DFT-s-OFDM 16QAM	Outer_Full
	Wgap				N/A	N/A
	SCC2/CC3				N/A	N/A
3	PCC/CC1				CP-OFDM QPSK	Outer_Full
	SCC1/CC2				CP-OFDM QPSK	Outer_Full
	Wgap				N/A	N/A
	SCC2/CC3				N/A	N/A
4	PCC/CC1				CP-OFDM 16QAM	Outer_Full
	SCC1/CC2				CP-OFDM 16QAM	Outer_Full
	Wgap				N/A	N/A
	SCC2/CC3				N/A	N/A
5	PCC/CC1				CP-OFDM 64QAM	Outer_Full
	SCC1/CC2				CP-OFDM 64QAM	Outer_Full
	Wgap				N/A	N/A
	SCC2/CC3				N/A	N/A
<b>Default Test Settings for a CA_nX(D-A)_UL_nXD Configuration (400MHz &lt;= Cumulative aggregated BWchannel &lt;800MHz)</b>						
1	PCC/CC1	200MHz	Default	-	DFT-s-OFDM QPSK	Outer_Full
	SCC1/CC2	200MHz			DFT-s-OFDM QPSK	Outer_Full
	Wgap	290MHz			N/A	N/A
	SCC2/CC3	100MHz			N/A	N/A
2	PCC/CC1	200MHz			CP-OFDM QPSK	Outer_Full
	SCC1/CC2	200MHz			CP-OFDM QPSK	Outer_Full
	Wgap	290MHz			N/A	N/A
	SCC2/CC3	100MHz			N/A	N/A
3	PCC/CC1	200MHz			CP-OFDM 16QAM	Outer_Full
	SCC1/CC2	200MHz			CP-OFDM	Outer_Full

	Wgap	290MHz			16QAM	
	SCC2/CC3	100MHz			N/A	N/A
					N/A	N/A
4	PCC/CC1	200MHz			CP-OFDM 64QAM	Outer_Full
	SCC1/CC2	200MHz			CP-OFDM 64QAM	Outer_Full
	Wgap	290MHz			N/A	N/A
	SCC2/CC3	100MHz			N/A	N/A
<b>Default Test Settings for a CA_nX(A-G)_UL_nXG, CA_nX(A-O)_UL_nXO Configuration (400MHz &lt;= Cumulative aggregated BWchannel &lt;800MHz)</b>						
1	PCC/CC1	100MHz	Default	-	DFT-s-OFDM QPSK	Outer_Full
	SCC1/CC2	100MHz			DFT-s-OFDM QPSK	Outer_Full
	Wgap	390MHz			N/A	N/A
	SCC2/CC3	200MHz			N/A	N/A
2	PCC/CC1	100MHz			CP-OFDM QPSK	Outer_Full
	SCC1/CC2	100MHz			CP-OFDM QPSK	Outer_Full
	Wgap	390MHz			N/A	N/A
	SCC2/CC3	200MHz			N/A	N/A
3	PCC/CC1	100MHz			CP-OFDM 16QAM	Outer_Full
	SCC1/CC2	100MHz			CP-OFDM 16QAM	Outer_Full
	Wgap	390MHz			N/A	N/A
	SCC2/CC3	200MHz			N/A	N/A
4	PCC/CC1	100MHz			c	Outer_Full
	SCC1/CC2	100MHz			CP-OFDM 64QAM	Outer_Full
	Wgap	390MHz			N/A	N/A
	SCC2/CC3	200MHz			N/A	N/A
<b>Default Test Settings for a CA_nX(D-A)_UL_nXD Configuration (Cumulative aggregated BWchannel &lt;400MHz)</b>						
1	PCC/CC1	50MHz	Default	-	CP-OFDM QPSK	Outer_Full
	SCC1/CC2	200MHz			CP-OFDM QPSK	Outer_Full
	Wgap	90MHz			N/A	N/A
	SCC2/CC3	50MHz			N/A	N/A
2	PCC/CC1	50MHz			CP-OFDM 16QAM	Outer_Full
	SCC1/CC2	200MHz			CP-OFDM 16QAM	Outer_Full
	Wgap	90MHz			N/A	N/A
	SCC2/CC3	50MHz			N/A	N/A
3	PCC/CC1	50MHz			CP-OFDM 64QAM	Outer_Full
	SCC1/CC2	200MHz			CP-OFDM 64QAM	Outer_Full
	Wgap	90MHz			N/A	N/A
	SCC2/CC3	50MHz			N/A	N/A
<b>Default Test Settings for a CA_nX(A-O)_UL_nXO Configuration (Cumulative aggregated BWchannel &lt;400MHz)</b>						
1	SCC1/CC2	200MHz			N/A	N/A
	Wgap	90MHz			N/A	N/A

	PCC/CC3	50MHz		CP-OFDM QPSK	Outer_Full
	SCC3/CC4	50MHz		CP-OFDM QPSK	Outer_Full
2				N/A	N/A
	SCC1/CC2	200MHz		N/A	N/A
	Wgap	90MHz		CP-OFDM 16QAM	Outer_Full
	PCC/CC3	50MHz		CP-OFDM 16QAM	Outer_Full
	SCC3/CC4	50MHz			
3				N/A	N/A
	SCC1/CC2	200MHz		N/A	N/A
	Wgap	90MHz		CP-OFDM 64QAM	Outer_Full
	PCC/CC3	50MHz		CP-OFDM 64QAM	Outer_Full
	SCC3/CC4	50MHz			

NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1.

NOTE 2: PCC/CCi and SCC/CCj means PCC is on component carrier CCi and SCC is on component carrier CCj, with CCi or CCj frequencies defined in TS38.508-1 [10].

**Table 6.2A.2.1.4.1-7: Intra-band Contiguous UL CA Test Configuration Table (Power Class 2, 3 and 4, Non-contiguous allocation)**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal			
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes			Mid range			
Test CC Combination setting (aggregated BW of the CA configuration) as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE			Highest aggregated channel bandwidth of the CA configuration			
Test SCS as specified in Table 5.3.5-1			120 kHz			
Test Parameters						
Test ID	CC & Mapping (NOTE 2)	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation
Default Test Settings for a CA_XG, CA_nXO Configuration (Cumulative aggregated BWchannel < 400MHz)						
1	PCC/CC1	Default	Default	-	DFT-s-OFDM QPSK	Outer_1RB_Left
	SCC/CC2				DFT-s-OFDM QPSK	Outer_1RB_Right
2	PCC/CC1	Default	Default	-	DFT-s-OFDM Pi/2 BPSK	[Outer_0.9_Left]
	SCC/CC2				DFT-s-OFDM Pi/2 BPSK	[Outer_0.9_Right]
3	PCC/CC1	Default	Default	-	DFT-s-OFDM Pi/2 QPSK	[Outer_0.9_Left]
	SCC/CC2				DFT-s-OFDM Pi/2 QPSK	[Outer_0.9_Right]

NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1.

NOTE 2: PCC/CCi and SCC/CCj means PCC is on component carrier CCi and SCC is on component carrier CCj, with CCi or CCj frequencies defined in TS38.508-1 [10].

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement channels are set according to Table 6.2A.2.1.4.1-1 to Table 6.2A.2.1.4.1-7.
5. Propagation conditions are set according to Annex B.0.

6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.2A.2.1.4.3.

#### 6.2A.2.1.4.2 Test procedure

1. Configure SCC according to Annex C.0, C.1, C.2 and Annex C.3.0 for all downlink physical channels
2. The SS shall configure SCC as per TS 38.508-1 [10] subclause 5.5.1 Procedure to configure SCC(s) for NR RF CA testing. Message contents are defined in subclause 6.2A.2.1.4.3.
3. Apply the test step based on the 5G NR UE Release:
  - 3a. For Release 16 and forward 5G NR UEs supporting the UPLF test mode: SS applies a backoff on the PCell power by activating the UE Power Limit Function (UPLF). The ACTIVATE POWER LIMIT REQUEST procedure is performed as specified in TS 38.508-1 [10] clause 4.9.32 using condition 'NR FR2 2CA'. UE shall transmit ACTIVATE POWER LIMIT RESPONSE to SS. Go to step 4.
  - 3b. For Release 15 5G NR UEs: No action.
  - 3c. For testing single CC MPR requirement: No action.
4. SS activates SCC by sending the activation MAC CE (Refer TS 38.321, clauses 5.9, 6.1.3.10). Wait for at least 2 seconds (Refer TS 38.133[25], clause 9.3).
5. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.2A.2.1.4.1-1 to Table 6.2A.2.1.4.1-7. Since the UL has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC.
6. Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
7. Apply the test step based on the 5G NR UE Release:
  - 7a. For Release 16 and forward 5G NR UEs: Send continuously uplink power control "up" commands in every uplink scheduling information to the UE; allow at least 200 msec starting from the first TPC command in this step to ensure that the UE transmits at its maximum output power. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
  - 7b. For Release 15 5G NR UEs: Send uplink power control commands in uplink scheduling information to the UE per UL CC until the Power Headroom Report (PHR) from the UE for each UL CC is at the target value according to Table 6.2A.2.1.4.2-1; allow at least 200 ms for the UE to reach maximum output power. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.

**Table 6.2A.2.1.4.2-1: Power target values per UL CC for test procedure using PHR**

BW ratio (Note 1)	Xmax [dB] (Note 2)	Target PHR	ΔPHR [dB] (Note 3)	BW combination examples
1/2	3.0	POWER_HEADROOM_36 (3 ≤ PH < 4)	1	2CC equal BW
1/3	4.8	POWER_HEADROOM_38 (5 ≤ PH < 6)	1.2	2CC 50+100 MHz CC1
2/3	1.8	POWER_HEADROOM_35 (2 ≤ PH < 3)	1.2	2CC 50+100 MHz CC2
1/5	7.0	POWER_HEADROOM_40 (7 ≤ PH < 8)	1.0	2CC 50+200 MHz CC1
4/5	1.0	POWER_HEADROOM_34 (1 ≤ PH < 2)	1.0	2CC 50+200 MHz CC2
1/9	9.5	POWER_HEADROOM_43 (10 ≤ PH < 11)	1.5	2CC 50+400 MHz CC1
8/9	0.5	POWER_HEADROOM_34 (1 ≤ PH < 2)	1.5	2CC 50+400 MHz CC2
Note 1:	The BW ratio is the ratio of BW of the CC over the total Aggregated UL BW			
Note 2:	Xmax = 10log(BW ratio)			
Note 3:	ΔPHR is the worst case UE output power decrease due to Xmax and 1 dB reporting granularity of PHR according to TS38.133 [25].			

- 7c. For testing single CC MPR requirement: Send continuously uplink power control "up" commands in every uplink scheduling information to the UE; allow at least 200 msec starting from the first TPC command in this

step to ensure that the UE transmits at its maximum output power. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.

8. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
9. Measure UE EIRP in the Tx beam peak direction in the accumulative aggregated channel bandwidth of the radio access mode according to the test configuration, which shall meet the requirements described in 6.2A.2.1.5. EIRP test procedure is defined in Annex K.1.3. The measuring duration is one active uplink subframe. EIRP is calculated considering both polarizations, theta and phi.
10. Apply the test step based on the 5G NR UE Release:
  - 10a. For Release 16 and forward 5G NR UEs supporting the UPLF test mode: SS deactivates the UE Power Limit Function (UPLF) by performing the DEACTIVATE POWER LIMIT REQUEST procedure as specified in TS 38.508-1 [10] clause 4.9.33.
  - 10b. For Release 15 5G NR UEs: No action.
  - 10c. For testing single CC MPR requirement: No action.
11. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

NOTE 2: When switching to DFT-s-OFDM waveform, as specified in Table 6.2A.2.1.4.1-1 to Table 6.2A.2.1.4.1-7, send an NR RRCReconfiguration message according to TS 38.508-1 [10] clause 4.6.3 Table 4.6.3-118 PUSCH-Config with TRANSFORM\_PRECODER\_ENABLED condition.

#### 6.2A.2.1.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with the following exceptions for Release 15 5G NR UE.

**Table 6.2A.2.1.4.3-1: PUSCH-PowerControl**

Derivation Path: TS 38.508-1 [10], Table 4.6.3-120			
Information Element	Value/remark	Comment	Condition
PUSCH-PowerControl ::= SEQUENCE {			
tpc-Accumulation	disabled		
p0-AlphaSets SEQUENCE (SIZE (1..maxNrofP0-PUSCH-AlphaSets)) OF SEQUENCE {	1 entry		
P0-PUSCH-AlphaSet[1] SEQUENCE {			
alpha	alpha0		
}			
}			
}			

#### 6.2A.2.1.5 Test requirement

The EIRP derived in step 8 shall be within the range prescribed by the nominal maximum output power and tolerance in the applicable table from Table 6.2A.2.1.5-1 to Table 6.2A.2.1.5-17.

**Table 6.2A.2.1.5-1: MPR requirements for Intra-band Contiguous UL CA (Power Class 1, MPR<sub>narrow</sub>)**

Test ID	Band	Min peak EIRP (dBm)	MPR (dB)	T(MPR) (dB)	Lower limit (dBm)	Upper limit (dBm)
1	n257, n258, n261	40.0	14.4	[7.0]	[18.6]-TT	55
1	n260	38.0	14.4	[7.0]	[16.6]-TT	55
2	n257, n258, n261	40.0	14.4	[7.0]	[18.6]-TT	55
2	n260	38.0	14.4	[7.0]	[16.6]-TT	55
3	n257, n258, n261	40.0	10	[5]	[25.0]-TT	55
3	n260	38.0	10	[5]	[23.0]-TT	55

4	n257, n258, n261	40.0	10	[5]	[25.0]-TT	55
4	n260	38.0	10	[5]	[23.0]-TT	55

NOTE 1: TT for each band and accumulative aggregated bandwidth is specified in Table 6.2A.2.1.5-5.

**Table 6.2A.2.1.5-2: MPR requirements for Intra-band Contiguous UL CA (Power Class 1, single CC MPR requirement)**

Test ID	Band	Min peak EIRP (dBm)	MPR (dB)	T(MPR) (dB)	Lower limit (dBm)	Upper limit (dBm)
<b>Test requirements for a CA_nXG, CA_nXO Configuration (Cumulative aggregated BWchannel &lt;= 200MHz)</b>						
1	n257, n258, n261	40.0	5.5	[5.0]	[29.5]-TT	55
1	n260	38.0	5.5	[5.0]	[27.5]-TT	55
2	n257, n258, n261	40.0	3.0	[2.0]	[35.0]-TT	55
2	n260	38.0	3.0	[2.0]	[33.0]-TT	55
<b>Test requirements for a CA_nXD Configuration (Cumulative aggregated BWchannel &lt;= 400MHz)</b>						
1	n257, n258, n261	40.0	5.5	[5.0]	[29.5]-TT	55
1	n260	38.0	5.5	[5.0]	[27.5]-TT	55
2	n257, n258, n261	40.0	3.0	[2.0]	[35.0]-TT	55
2	n260	38.0	3.0	[2.0]	[33.0]-TT	55
3	n257, n258, n261	40.0	3.5	[3.0]	[33.5]-TT	55
3	n260	38.0	3.5	[3.0]	[31.5]-TT	55

NOTE 1: TT for each band and accumulative aggregated bandwidth is specified in Table 6.2A.2.1.5-5.

**Table 6.2A.2.1.5-3: MPR requirements for Intra-band Contiguous UL CA (Power Class 1, MPR<sub>C,CA</sub>)**

Test ID	Band	Min peak EIRP (dBm)	MPR (dB)	T(MPR) (dB)	Lower limit (dBm)	Upper limit (dBm)
<b>Test requirements for a CA_nXB, CA_nXC_UL_nXB Configuration (800MHz &lt;= Cumulative aggregated BWchannel &lt;= 1400MHz)</b>						
1	n257, n258, n261	40.0	8.2	[5.0]	[26.8]-TT	55
1	n260	38.0	8.2	[5.0]	[24.8]-TT	55
2	n257, n258, n261	40.0	9.7	[5.0]	[25.3]-TT	55
2	n260	38.0	9.7	[5.0]	[23.3]-TT	55
3	n257, n258, n261	40.0	9.2	[5.0]	[25.8]-TT	55
3	n260	38.0	9.2	[5.0]	[23.8]-TT	55
4	n257, n258, n261	40.0	8.7	[5.0]	[26.3]-TT	55
4	n260	38.0	8.7	[5.0]	[24.3]-TT	55
5	n257, n258, n261	40.0	11.2	[7.0]	[21.8]-TT	55
5	n260	38.0	11.2	[7.0]	[19.8]-TT	55
<b>Test requirements for a CA_nXD, CA_nXB Configuration (400MHz &lt;= Cumulative aggregated BWchannel &lt; 800MHz)</b>						
1	n257, n258, n261	40.0	7.7	[5.0]	[27.3]-TT	55
1	n260	38.0	7.7	[5.0]	[25.3]-TT	55
2	n257, n258, n261	40.0	8.7	[5.0]	[26.3]-TT	55
2	n260	38.0	8.7	[5.0]	[24.3]-TT	55
3	n257, n258, n261	40.0	10.7	[7.0]	[22.3]-TT	55
3	n260	38.0	10.7	[7.0]	[20.3]-TT	55



Test requirements for a CA_nXG, CA_nXO, CA_nXD Configuration (Cumulative aggregated BWchannel < 400MHz)						
1	n257, n258, n261	40.0	5.5	[5.0]	[29.5]-TT	55
1	n260	38.0	5.5	[5.0]	[27.5]-TT	55
2	n257, n258, n261	40.0	6.5	[5.0]	[28.5]-TT	55
2	n260	38.0	6.5	[5.0]	[26.5]-TT	55
3	n257, n258, n261	40.0	9.0	[5.0]	[26.0]-TT	55
3	n260	38.0	9.0	[5.0]	[24.0]-TT	55
Test requirements for a CA_nX(D-G)_UL_nXD, CA_nX(D-G)_UL_nXG, CA_nX(D-O)_UL_nXD, CA_nX(D-O)_UL_nXO, CA_nX(D-H)_UL_nXD, CA_nX(D-P)_UL_nXD, CA_nX(E-O)_UL_nXO, CA_nX(D-I)_UL_nXD, CA_nX(D-Q)_UL_nXD, CA_nX(G-I)_UL_nXG Configuration (800MHz <= Cumulative aggregated BWchannel <= 1400MHz)						
1	n257, n258, n261	40.0	8.2	[5.0]	[26.8]-TT	55
1	n260	38.0	8.2	[5.0]	[24.8]-TT	55
2	n257, n258, n261	40.0	9.7	[5.0]	[25.3]-TT	55
2	n260	38.0	9.7	[5.0]	[23.3]-TT	55
3	n257, n258, n261	40.0	9.2	[5.0]	[25.8]-TT	55
3	n260	38.0	9.2	[5.0]	[23.8]-TT	55
4	n257, n258, n261	40.0	8.7	[5.0]	[26.3]-TT	55
4	n260	38.0	8.7	[5.0]	[24.3]-TT	55
5	n257, n258, n261	40.0	11.2	[7.0]	[21.8]-TT	55
5	n260	38.0	11.2	[7.0]	[19.8]-TT	55
Test requirements for a CA_nX(D-G)_UL_nXD, CA_nX(D-O)_UL_nXD, CA_nX(D-G)_UL_nXG, CA_nX(D-O)_UL_nXO, CA_nX(D-H)_UL_nXD, CA_nX(D-P)_UL_nXD, CA_nX(O-E)_UL_nXO, CA_nX(D-I)_UL_nXD, CA_nX(D-Q)_UL_nXD, CA_nX(G-I)_UL_nXG Configuration (400MHz <= Cumulative aggregated BWchannel <800MHz)						
1	n257, n258, n261	40.0	7.7	[5.0]	[27.3]-TT	55
1	n260	38.0	7.7	[5.0]	[25.3]-TT	55
2	n257, n258, n261	40.0	8.7	[5.0]	[26.3]-TT	55
2	n260	38.0	8.7	[5.0]	[24.3]-TT	55
3	n257, n258, n261	40.0	10.7	[7.0]	[22.3]-TT	55
3	n260	38.0	10.7	[7.0]	[20.3]-TT	55
Test requirements for a CA_nX(D-O)_UL_nXD, CA_nX(D-O)_UL_nXO Configuration (Cumulative aggregated BWchannel <400MHz)						
1	n257, n258, n261	40.0	5.5	[5.0]	[29.5]-TT	55
1	n260	38.0	5.5	[5.0]	[27.5]-TT	55
2	n257, n258, n261	40.0	6.5	[5.0]	[28.5]-TT	55
2	n260	38.0	6.5	[5.0]	[26.5]-TT	55
3	n257, n258, n261	40.0	9.0	[5.0]	[26.0]-TT	55
3	n260	38.0	9.0	[5.0]	[24.0]-TT	55

NOTE 1: TT for each band and accumulative aggregated bandwidth is specified in Table 6.2A.2.1.5-5.

**Table 6.2A.2.1.5-4: MPR requirements for Intra-band Contiguous UL CA (Power Class 1, Non-contiguous allocation)**

Test ID	Band	Min peak EIRP (dBm)	MPR (dB)	T(MPR) (dB)	Lower limit (dBm)	Upper limit (dBm)
<b>Test requirements for a CA_nXB, CA_nXD, CA_XG, CA_nXO Configuration</b>						
1	n257, n258, n261	40.0	[14.4]	[7.0]	[18.6] -TT	55
1	n260	38.0	[14.4]	[7.0]	[16.6] -TT	55
2	n257, n258, n261	FFS	FFS	FFS	FFS	FFS
2	n260	FFS	FFS	FFS	FFS	FFS
3	n257, n258, n261	FFS	FFS	FFS	FFS	FFS
3	n260	FFS	FFS	FFS	FFS	FFS
<b>Test requirements for a CA_nX(D-G), CA_nX(D-O) Configuration</b>						
1	n257, n258, n261	40.0	[14.4]	[7.0]	[18.6] -TT	55
1	n260	38.0	[14.4]	[7.0]	[16.6] -TT	55
2	n257, n258, n261	FFS	FFS	FFS	FFS	FFS
2	n260	FFS	FFS	FFS	FFS	FFS
3	n257, n258, n261	FFS	FFS	FFS	FFS	FFS
3	n260	FFS	FFS	FFS	FFS	FFS

NOTE 1: TT for each band and accumulative aggregated bandwidth is specified in Table 6.2A.2.1.5-5.

**Table 6.2A.2.1.5-5: Test Tolerance (MPR for CA for Power class 1)**

FFS

**Table 6.2A.2.1.5-6: MPR requirements for Intra-band Contiguous UL CA (Power Class 2, single CC MPR requirement)**

Test ID	Band	Min peak EIRP (dBm)	MPR (dB)	T(MPR) (dB)	Lower limit (dBm)	Upper limit (dBm)
<b>Test requirements for a CA_nXG, CA_nXO Configuration (Cumulative aggregated BWchannel &lt;= 200MHz)</b>						
1	n257, n258, n261	29	0	0	29.0-TT	43
2	n257, n258, n261	29	2	[1.5]	[25.5]-TT	43
<b>Test requirements for a CA_nXD Configuration (Cumulative aggregated BWchannel &lt;= 400MHz)</b>						
1	n257, n258, n261	29	0	0	29.0-TT	43
2	n257, n258, n261	29	3	[2.0]	[24.0]-TT	43

NOTE 1: TT for each band and accumulative aggregated bandwidth is specified in Table 6.2A.2.1.5-9.

**Table 6.2A.2.1.5-7: MPR requirements for Intra-band Contiguous UL CA (Power Class 2, MPR<sub>C,CA</sub>)**

Test ID	Band	Min peak EIRP (dBm)	MPR (dB)	T(MPR) (dB)	Lower limit (dBm)	Upper limit (dBm)
<b>Test requirements for a CA_nXB, nXC_UL_nXB Configuration (800MHz &lt;= Cumulative aggregated BWchannel &lt;= 1400MHz)</b>						
1	n257, n258, n261	29	8.2	[5.0]	[15.8]-TT	43
2	n257, n258, n261	29	9.3	[5.0]	[14.7]-TT	43
3	n257, n258, n261	29	8.0	[5.0]	[16.0]-TT	43
4	n257, n258, n261	29	9.2	[5.0]	[14.8]-TT	43
5	n257, n258, n261	29	11.2	[7.0]	[10.8]-TT	43
<b>Test requirements for a CA_nXD, CA_nXB Configuration (400MHz &lt;= Cumulative aggregated BWchannel &lt; 800MHz)</b>						
1	n257, n258, n261	29	7.7	[5.0]	[16.3]-TT	43
2	n257, n258, n261	29	7.5	[5.0]	[16.5]-TT	43

					TT	
3	n257, n258, n261	29	8.7	[5.0]	[15.3]-TT	43
4	n257, n258, n261	29	10.7	[7.0]	[11.3]-TT	43
<b>Test requirements for a CA_nXG, CA_nXO, CA_nXD Configuration (Cumulative aggregated BWchannel &lt; 400MHz)</b>						
1	n257, n258, n261	29	5	[4.0]	[20.0]-TT	43
2	n257, n258, n261	29	6.5	[5.0]	[17.5]-TT	43
3	n257, n258, n261	29	9	[5.0]	[15.0]-TT	43
<b>Test requirements for a CA_nX(D-G) )_UL_nXD, CA_nX(D-G)_UL_nXG, CA_nX(D-O)_UL_nXD, CA_nX(D-O)_UL_nXO, CA_nX(D-H)_UL_nXD, CA_nX(D-P)_UL_nXD, CA_nX(E-O)_UL_nXO, CA_nX(D-I)_UL_nXD, CA_nX(D-Q)_UL_nXD, CA_nX(G-I)_UL_nXG Configuration (800MHz &lt;= Cumulative aggregated BWchannel &lt;= 1400MHz)</b>						
1	n257, n258, n261	29	8.2	[5.0]	[15.8]-TT	43
2	n257, n258, n261	29	9.3	[5.0]	[14.7]-TT	43
3	n257, n258, n261	29	8.0	[5.0]	[16.0]-TT	43
4	n257, n258, n261	29	9.2	[5.0]	[14.8]-TT	43
5	n257, n258, n261	29	11.2	[7.0]	[10.8]-TT	43
<b>Test requirements for a CA_nX(D-G)_UL_nXD, CA_nX(D-O)_UL_nXD, CA_nX(D-G)_UL_nXG, CA_nX(D-O)_UL_nXO, CA_nX(D-H)_UL_nXD, CA_nX(D-P)_UL_nXD, CA_nX(O-E)_UL_nXO, CA_nX(D-I)_UL_nXD, CA_nX(D-Q)_UL_nXD, CA_nX(G-I)_UL_nXG Configuration (400MHz &lt;= Cumulative aggregated BWchannel &lt; 800MHz)</b>						
1	n257, n258, n261	29	7.7	[5.0]	[16.3]-TT	43
2	n257, n258, n261	29	7.5	[5.0]	[16.5]-TT	43
3	n257, n258, n261	29	8.7	[5.0]	[15.3]-TT	43
4	n257, n258, n261	29	10.7	[7.0]	[11.3]-TT	43
<b>Test requirements for a CA_nX(D-O)_UL_nXD, CA_nX(D-O)_UL_nXO Configuration (Cumulative aggregated BWchannel &lt; 400MHz)</b>						
1	n257, n258, n261	29	7.7	[5.0]	[16.3]-TT	43
2	n257, n258, n261	29	7.5	[5.0]	[16.5]-TT	43
3	n257, n258, n261	29	8.7	[5.0]	[15.3]-TT	43
NOTE 1: TT for each band and accumulative aggregated bandwidth is specified in Table 6.2A.2.1.5-9.						

**Table 6.2A.2.1.5-8: MPR requirements for Intra-band Contiguous UL CA (Power Class 2, Non-contiguous allocation)**

Test ID	Band	Min peak EIRP (dBm)	MPR (dB)	T(MPR) (dB)	Lower limit (dBm)	Upper limit (dBm)
<b>Test requirements for a CA_nXB, CA_nXD, CA_XG, CA_nXO Configuration</b>						
1	n257, n258, n261	29	7	[5.0]	[17.0] -TT	43
2	n257, n258, n261	FFS	FFS	FFS	FFS	FFS
3	n257, n258, n261	FFS	FFS	FFS	FFS	FFS
NOTE 1: TT for each band and accumulative aggregated bandwidth is specified in Table 6.2A.2.1.5-9.						

**Table 6.2A.2.1.5-9: Test Tolerance (MPR for CA for Power class 2)**

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**Table 6.2A.2.1.5-10: MPR requirements for Intra-band Contiguous UL CA (Power Class 3, single CC MPR requirement)**

Test ID	Band	Min peak EIRP (dBm)	MPR (dB)	T(MPR) (dB)	Lower limit (dBm)	Upper limit (dBm)
<b>Test requirements for a CA_nXG, CA_nXO Configuration (Cumulative aggregated BWchannel &lt;= 200MHz)</b>						
1	n257, n258, n261	22.4	0	0	22.4-TT	43
1	n260	20.6	0	0	20.6-TT	43
2	n257, n258, n261	22.4	2	[1.5]	[18.9]-TT	43
2	n260	20.6	2	[1.5]	[17.1]-TT	43
<b>Test requirements for a CA_nXD Configuration (Cumulative aggregated BWchannel &lt;= 400MHz)</b>						
1	n257, n258, n261	22.4	0	0	22.4-TT	43
1	n260	20.6	0	0	20.6-TT	43
2	n257, n258, n261	22.4	3	[2.0]	[17.4]-TT	43
2	n260	20.6	3	[2.0]	[15.6]-TT	43
NOTE 1: TT for each band and accumulative aggregated bandwidth is specified in Table 6.2A.2.1.5-13.						

**Table 6.2A.2.1.5-11: MPR requirements for Intra-band Contiguous UL CA (Power Class 3, MPR<sub>C\_CA</sub>)**

Test ID	Band	Min peak EIRP (dBm)	MPR (dB)	Lower limit for test procedure with UPLF test mode (variant a, Rel-16 and later)		Lower limit for test procedure with PHR (variant b, Rel-15 only)		Upper limit (dBm)
				T(MPR) (dB)	Lower limit (dBm)	T(MPR+ ΔPHR) (dB)	Lower limit PHR(dBm)	
<b>Test requirements for a CA_nXB, nXC_UL_nXB Configuration (800MHz &lt;= Cumulative aggregated BWchannel &lt;= 1400MHz)</b>								
1	n257, n258, n261	22.4	8.2	[5.0]	[9.2]-TT	[5.0]	[9.2]-ΔPHR-TT	43
1	n260	20.6	8.2	[5.0]	[7.4]-TT	[5.0]	[7.4]- ΔPHR-TT	43
2	n257, n258, n261	22.4	9.3	[5.0]	[8.1]-TT	[5.0]+2	[6.1]- ΔPHR-TT	43
2	n260	20.6	9.3	[5.0]	[6.3]-TT	[5.0]+2	[4.3]- ΔPHR-TT	43
3	n257, n258, n261	22.4	8.0	[5.0]	[9.4]-TT	[5.0]	[9.4]- ΔPHR-TT	43
3	n260	20.6	8.0	[5.0]	[7.6]-TT	[5.0]	[7.6]- ΔPHR-TT	43
4	n257, n258, n261	22.4	9.2	[5.0]	[8.2]-TT	[5.0]+2	[6.2]- ΔPHR-TT	43
4	n260	20.6	9.2	[5.0]	[6.4]-TT	[5.0]+2	[4.4]- ΔPHR-TT	43
5	n257, n258, n261	22.4	11.2	[7.0]	[4.2]-TT	[7.0]	[4.2]- ΔPHR-TT	43
5	n260	20.6	11.2	[7.0]	[2.4]-TT	[7.0]	[2.4]- ΔPHR-TT	43
<b>Test requirements for a CA_nXD, CA_nXB Configuration (Cumulative aggregated BWchannel &lt; 800MHz)</b>								
1	n257, n258, n261	22.4	7.7	[5.0]	[9.7]-TT	[5.0]	[9.7]- ΔPHR-TT	43
1	n260	20.6	7.7	[5.0]	[7.9]-TT	[5.0]	[7.9]- ΔPHR-TT	43
2	n257, n258, n261	22.4	7.5	[5.0]	[9.9]-TT	[5.0]	[9.9]- ΔPHR-TT	43
2	n260	20.6	7.5	[5.0]	[8.1]-TT	[5.0]	[8.1]- ΔPHR-TT	43
3	n257, n258, n261	22.4	8.7	[5.0]	[8.7]-TT	[5.0]	[8.7]- ΔPHR-TT	43
3	n260	20.6	8.7	[5.0]	[6.9]-TT	[5.0]	[6.9]- ΔPHR-TT	43
4	n257, n258, n261	22.4	10.7	[7.0]	[4.7]-TT	[7.0]	[4.7]- ΔPHR-TT	43
4	n260	20.6	10.7	[7.0]	[2.9]-TT	[7.0]	[2.9]- ΔPHR-TT	43
<b>Test requirements for a CA_nXG, CA_nXO, CA_nXD Configuration (Cumulative aggregated BWchannel &lt; 400MHz)</b>								
1	n257, n258, n261	22.4	5	[4.0]	[13.4]-TT	[4.0]+1	[12.4]-	43

							$\Delta$ PHR-TT	
1	n260	20.6	5	[4.0]	[11.6]-TT	[4.0]+1	[10.6]- $\Delta$ PHR-TT	43
2	n257, n258, n261	22.4	6.5	[5.0]	[10.9]-TT	[5.0]	[10.9]- $\Delta$ PHR-TT	43
2	n260	20.6	6.5	[5.0]	[9.1]-TT	[5.0]	[9.1]- $\Delta$ PHR-TT	43
3	n257, n258, n261	22.4	9	[5.0]	[8.4]-TT	[5.0]	[8.4]- $\Delta$ PHR-TT	43
3	n260	20.6	9	[5.0]	[6.6]-TT	[5.0]	[6.6]- $\Delta$ PHR-TT	43
<b>Test requirements for a CA_nX(D-A) _UL_nXD, CA_nX(A-G)_UL_nXG, CA_nX(A-O)_UL_nXO Configuration (800MHz &lt;= Cumulative aggregated BWchannel &lt;= 1400MHz)</b>								
1	n257, n258, n261	22.4	8.2	[5.0]	[9.2]-TT	[5.0]	[9.2]- $\Delta$ PHR-TT	43
1	n260	20.6	8.2	[5.0]	[7.4]-TT	[5.0]	[7.4]- $\Delta$ PHR-TT	43
2	n257, n258, n261	22.4	9.3	[5.0]	[8.1]-TT	[5.0]+2	[6.1]- $\Delta$ PHR-TT	43
2	n260	20.6	9.3	[5.0]	[6.3]-TT	[5.0]+2	[4.3]- $\Delta$ PHR-TT	43
3	n257, n258, n261	22.4	8.0	[5.0]	[9.4]-TT	[5.0]	[9.4]- $\Delta$ PHR-TT	43
3	n260	20.6	8.0	[5.0]	[7.6]-TT	[5.0]	[7.6]- $\Delta$ PHR-TT	43
4	n257, n258, n261	22.4	9.2	[5.0]	[8.2]-TT	[5.0]+2	[6.2]- $\Delta$ PHR-TT	43
4	n260	20.6	9.2	[5.0]	[6.4]-TT	[5.0]+2	[4.4]- $\Delta$ PHR-TT	43
5	n257, n258, n261	22.4	11.2	[7.0]	[4.2]-TT	[7.0]	[4.2]- $\Delta$ PHR-TT	43
5	n260	20.6	11.2	[7.0]	[2.4]-TT	[7.0]	[2.4]- $\Delta$ PHR-TT	43
<b>Test requirements for a CA_nX(D-A)_UL_nXD, CA_nX(A-G)_UL_nXG, CA_nX(A-O) Configuration (Cumulative aggregated BWchannel &lt; 800MHz)</b>								
1	n257, n258, n261	22.4	7.7	[5.0]	[9.7]-TT	[5.0]	[9.7]- $\Delta$ PHR-TT	43
1	n260	20.6	7.7	[5.0]	[7.9]-TT	[5.0]	[7.9]- $\Delta$ PHR-TT	43
2	n257, n258, n261	22.4	7.5	[5.0]	[9.9]-TT	[5.0]	[9.9]- $\Delta$ PHR-TT	43
2	n260	20.6	7.5	[5.0]	[8.1]-TT	[5.0]	[8.1]- $\Delta$ PHR-TT	43
3	n257, n258, n261	22.4	8.7	[5.0]	[8.7]-TT	[5.0]	[8.7]- $\Delta$ PHR-TT	43
3	n260	20.6	8.7	[5.0]	[6.9]-TT	[5.0]	[6.9]- $\Delta$ PHR-TT	43
4	n257, n258, n261	22.4	10.7	[7.0]	[4.7]-TT	[7.0]	[4.7]- $\Delta$ PHR-TT	43
4	n260	20.6	10.7	[7.0]	[2.9]-TT	[7.0]	[2.9]- $\Delta$ PHR-TT	43
<b>Test requirements for a CA_nX(D-A)_UL_nXD, CA_nX(A-O)_UL_nXO Configuration (Cumulative aggregated BWchannel &lt; 400MHz)</b>								
1	n257, n258, n261	22.4	5	[4.0]	[13.4]-TT	[4.0]+1	[12.4]- $\Delta$ PHR-TT	43
1	n260	20.6	5	[4.0]	[11.6]-TT	[4.0]+1	[10.6]- $\Delta$ PHR-TT	43
2	n257, n258, n261	22.4	6.5	[5.0]	[10.9]-TT	[5.0]	[10.9]- $\Delta$ PHR-TT	43
2	n260	20.6	6.5	[5.0]	[9.1]-TT	[5.0]	[9.1]- $\Delta$ PHR-TT	43
3	n257, n258, n261	22.4	9	[5.0]	[8.4]-TT	[5.0]	[8.4]- $\Delta$ PHR-TT	43
3	n260	20.6	9	[5.0]	[6.6]-TT	[5.0]	[6.6]- $\Delta$ PHR-TT	43
NOTE 1: TT for each band and accumulative aggregated bandwidth is specified in Table 6.2A.2.1.5-13.								
NOTE 2: $\Delta$ PHR is defined in Table 6.2A.2.1.4.2-1								

NOTE 3: test procedure with PHR (variant b)

**Table 6.2A.2.1.5-12: MPR requirements for Intra-band Contiguous UL CA (Power Class 3, Non-contiguous allocation)**

Test ID	Band	Min peak EIRP (dBm)	MPR (dB)	Lower limit for test procedure with UPLF test mode (variant a)		Lower limit for test procedure with PHR (variant b)		Upper limit (dBm)
				T(MPR) (dB)	Lower limit (dBm)	T(MPR+ΔPHR) (dB)	Lower limit PHR(dBm)	
<b>Test requirements for a CA_nXB, CA_nXD, CA_XG, CA_nXO Configuration</b>								
1	n257, n258, n261	22.4	7	[5.0]	[10.4]-TT	[5.0]	[10.4]-ΔPHR -TT	43
1	n260	20.6	7	[5.0]	[8.6]-TT	[5.0]	[8.6]-ΔPHR -TT	43
2	n257, n258, n261	FFS	FFS	FFS	FFS	FFS	FFS	FFS
2	n260	FFS	FFS	FFS	FFS	FFS	FFS	FFS
3	n257, n258, n261	FFS	FFS	FFS	FFS	FFS	FFS	FFS
3	n260	FFS	FFS	FFS	FFS	FFS	FFS	FFS

NOTE 1: TT for each band and accumulative aggregated bandwidth is specified in Table 6.2A.2.1.5-13.  
 NOTE 2: ΔPHR is defined in Table 6.2A.2.1.4.2-1

**Table 6.2A.2.1.5-13: Test Tolerance (MPR for CA for Power class 3) (Aggregated UL BW ≤ 400MHz)**

Test Metric	FR2a	FR2b
Max device size ≤ 30 cm	3.11 dB	3.11 dB

**Table 6.2A.2.1.5-14: MPR requirements for Intra-band Contiguous UL CA (Power Class 4, single CC MPR requirement)**

Test ID	Band	Min peak EIRP (dBm)	MPR (dB)	T(MPR) (dB)	Lower limit (dBm)	Upper limit (dBm)
<b>Test requirements for a CA_nXG, CA_nXO Configuration (Cumulative aggregated BWchannel ≤ 200MHz)</b>						
1	n257, n258, n261	34	0	0	34.0-TT	43
1	n260	31	0	0	31.0-TT	43
2	n257, n258, n261	34	2	[1.5]	[30.5]-TT	43
2	n260	31	2	[1.5]	[27.5]-TT	43
<b>Test requirements for a CA_nXD Configuration (Cumulative aggregated BWchannel ≤ 400MHz)</b>						
1	n257, n258, n261	34	0	0	34.0-TT	43
1	n260	31	0	0	31.0-TT	43
2	n257, n258, n261	34	3	[2.0]	[29.0]-TT	43
2	n260	31	3	[2.0]	[26.0]-TT	43

NOTE 1: TT for each band and accumulative aggregated bandwidth is specified in Table 6.2A.2.1.5-17.

**Table 6.2A.2.1.5-15: MPR requirements for Intra-band Contiguous UL CA (Power Class 4, MPR\_C\_CA)**

Test ID	Band	Min peak EIRP (dBm)	MPR (dB)	T(MPR) (dB)	Lower limit (dBm)	Upper limit (dBm)
<b>Test requirements for a CA_nXB, nXC_UL_nXB Configuration (800MHz ≤ Cumulative aggregated BWchannel ≤ 1400MHz)</b>						
1	n257, n258, n261	34	8.2	[5.0]	[20.8]-TT	43
1	n260	31	8.2	[5.0]	[17.8]-TT	43
2	n257, n258, n261	34	9.3	[5.0]	[19.7]-	43

2	n260	31	9.3	[5.0]	TT	43
3	n257, n258, n261	34	8.0	[5.0]	[16.7]- TT	43
3	n260	31	8.0	[5.0]	[21.0]- TT	43
3	n260	31	8.0	[5.0]	[18.0]- TT	43
4	n257, n258, n261	34	9.2	[5.0]	[19.8]- TT	43
4	n260	31	9.2	[5.0]	[16.8]- TT	43
5	n257, n258, n261	34	11.2	[7.0]	[15.8]- TT	43
5	n260	31	11.2	[7.0]	[12.8]- TT	43
<b>Test requirements for a CA_nXD, CA_nXB Configuration (Cumulative aggregated BWchannel &lt; 800MHz)</b>						
1	n257, n258, n261	34	7.7	[5.0]	[21.3]- TT	43
1	n260	31	7.7	[5.0]	[18.3]- TT	43
2	n257, n258, n261	34	7.5	[5.0]	[21.5]- TT	43
2	n260	31	7.5	[5.0]	[18.5]- TT	43
3	n257, n258, n261	34	8.7	[5.0]	[20.3]- TT	43
3	n260	31	8.7	[5.0]	[17.3]- TT	43
4	n257, n258, n261	34	10.7	[7.0]	[16.3]- TT	43
4	n260	31	10.7	[7.0]	[13.3]- TT	43
<b>Test requirements for a CA_nXG, CA_nXO, CA_nXD Configuration (Cumulative aggregated BWchannel &lt; 400MHz)</b>						
1	n257, n258, n261	34	5	[4.0]	[25.0]- TT	43
1	n260	31	5	[4.0]	[22.0]- TT	43
2	n257, n258, n261	34	6.5	[5.0]	[22.5]- TT	43
2	n260	31	6.5	[5.0]	[19.5]- TT	43
3	n257, n258, n261	34	9	[5.0]	[20.0]- TT	43
3	n260	31	9	[5.0]	[17.0]- TT	43
<b>Test requirements for a CA_nX(D-G) )_UL_nXD, CA_nX(D-G)_UL_nXG, CA_nX(D-O)_UL_nXD, CA_nX(D-O)_UL_nXO, CA_nX(D-H)_UL_nXD, CA_nX(D-P)_UL_nXD, CA_nX(E-O)_UL_nXO, CA_nX(D-I)_UL_nXD, CA_nX(D-Q)_UL_nXD, CA_nX(G-I)_UL_nXG Configuration (800MHz &lt;= Cumulative aggregated BWchannel &lt;= 1400MHz)</b>						
1	n257, n258, n261	34	8.2	[5.0]	[20.8]- TT	43
1	n260	31	8.2	[5.0]	[17.8]- TT	43
2	n257, n258, n261	34	9.3	[5.0]	[19.7]- TT	43
2	n260	31	9.3	[5.0]	[16.7]- TT	43
3	n257, n258, n261	34	8.0	[5.0]	[21.0]- TT	43
3	n260	31	8.0	[5.0]	[18.0]- TT	43
4	n257, n258, n261	34	9.2	[5.0]	[19.8]- TT	43
4	n260	31	9.2	[5.0]	[16.8]- TT	43
5	n257, n258, n261	34	11.2	[7.0]	[15.8]- TT	43

5	n260	31	11.2	[7.0]	[12.8]-TT	43
<b>Test requirements for a CA_nX(D-G)_UL_nXD, CA_nX(D-O)_UL_nXD, CA_nX(D-G)_UL_nXG, CA_nX(D-O)_UL_nXO, CA_nX(D-H)_UL_nXD, CA_nX(D-P)_UL_nXD, CA_nX(O-E)_UL_nXO, CA_nX(D-I)_UL_nXD, CA_nX(D-Q)_UL_nXD, CA_nX(G-I)_UL_nXG Configuration (Cumulative aggregated BWchannel &lt; 800MHz)</b>						
1	n257, n258, n261	34	7.7	[5.0]	[21.3]-TT	43
1	n260	31	7.7	[5.0]	[18.3]-TT	43
2	n257, n258, n261	34	7.5	[5.0]	[21.5]-TT	43
2	n260	31	7.5	[5.0]	[18.5]-TT	43
3	n257, n258, n261	34	8.7	[5.0]	[20.3]-TT	43
3	n260	31	8.7	[5.0]	[17.3]-TT	43
4	n257, n258, n261	34	10.7	[7.0]	[16.3]-TT	43
4	n260	31	10.7	[7.0]	[13.3]-TT	43
<b>Test requirements for a CA_nX(D-O)_UL_nXD, CA_nX(D-O)_UL_nXO Configuration (Cumulative aggregated BWchannel &lt; 400MHz)</b>						
1	n257, n258, n261	34	5	[4.0]	[25.0]-TT	43
1	n260	31	5	[4.0]	[22.0]-TT	43
2	n257, n258, n261	34	6.5	[5.0]	[22.5]-TT	43
2	n260	31	6.5	[5.0]	[19.5]-TT	43
3	n257, n258, n261	34	9	[5.0]	[20.0]-TT	43
3	n260	31	9	[5.0]	[17.0]-TT	43
NOTE 1: TT for each band and accumulative aggregated bandwidth is specified in Table 6.2A.2.1.5-17.						

**Table 6.2A.2.1.5-16: MPR requirements for Intra-band Contiguous UL CA (Power Class 4, Non-contiguous allocation)**

Test ID	Band	Min peak EIRP (dBm)	MPR (dB)	T(MPR) (dB)	Lower limit (dBm)	Upper limit (dBm)
<b>Test requirements for a CA_nXB, CA_nXD, CA_XG, CA_nXO Configuration</b>						
1	n257, n258, n261	34	7	[5.0]	[22.0]-TT	43
1	n260	31	7	[5.0]	[19.0]-TT	43
2	n257, n258, n261	FFS	FFS	FFS	FFS	FFS
2	n260	FFS	FFS	FFS	FFS	FFS
3	n257, n258, n261	FFS	FFS	FFS	FFS	FFS
3	n260	FFS	FFS	FFS	FFS	FFS
NOTE 1: TT for each band and accumulative aggregated bandwidth is specified in Table 6.2A.2.1.5-17.						

**Table 6.2A.2.1.5-17: Test Tolerance (MPR for CA for Power class 4)**

FFS

6.2A.2.2 UE maximum output power reduction for CA (3UL CA)

FFS

6.2A.2.3 UE maximum output power reduction for CA (4UL CA)

FFS



6.2A.2.4 UE maximum output power reduction for CA (5UL CA)

FFS

6.2A.2.5 UE maximum output power reduction for CA (6UL CA)

FFS

6.2A.2.6 UE maximum output power reduction for CA (7UL CA)

FFS

6.2A.2.7 UE maximum output power reduction for CA (8UL CA)

FFS

6.2A.3 UE maximum output power with additional requirements for CA

6.2A.3.0 Minimum conformance requirements

FFS

6.2A.3.1 UE maximum output power with additional requirements for CA (2UL CA)

FFS

6.2A.3.2 UE maximum output power with additional requirements for CA (3UL CA)

FFS

6.2A.3.3 UE maximum output power with additional requirements for CA (4UL CA)

FFS

6.2A.3.4 UE maximum output power with additional requirements for CA (5UL CA)

FFS

6.2A.3.5 UE maximum output power with additional requirements for CA (6UL CA)

FFS

6.2A.3.6 UE maximum output power with additional requirements for CA (7UL CA)

FFS

6.2A.3.7 UE maximum output power with additional requirements for CA (8UL CA)

FFS

6.2A.4 Configured transmitted power for CA

6.2A.4.0 Minimum conformance requirements

A UE configured with carrier aggregation can configure its maximum output power for each uplink carrier  $f$  of activated serving cell  $c$  and its total configured output power  $P_{\text{CMAX}}$ . The definition of the configured UE maximum output power  $P_{\text{CMAX},f,c}$  for each carrier  $f$  of a serving cell  $c$  is used for power headroom reporting for carrier  $f$  of serving cell  $c$  only and

is in accordance with that specified in clause 6.2.4 with parameters MPR, A-MPR and P-MPR replaced with those specified below. The UE maximum configured power  $P_{\text{CMAX}}$  in a transmission occasion is determined by the UL grants for carriers  $f$  of all serving cells  $c$  with non-zero granted power in the respective reference point.

For uplink intra-band contiguous carrier aggregation, MPR is specified in subclause 6.2A.2.  $P_{\text{CMAX}}$  is calculated under the assumption that power spectral density for each RB in each component carrier is same.

The configured UE maximum output power  $P_{\text{CMAX}}$  shall be set such that the corresponding measured total peak EIRP  $P_{\text{UMAX}}$  is within the following bounds

$$P_{\text{Powerclass}} - \text{MAX}(\text{MAX}(\text{MPR}, \text{A-MPR}) + \Delta\text{MB}_{\text{P,n}}, \text{P-MPR}) - \text{MAX}\{\text{T}(\text{MAX}(\text{MPR}, \text{A-MPR})), \text{T}(\text{P-MPR})\} \leq P_{\text{UMAX}} \leq \text{EIRP}_{\text{max}}$$

with  $P_{\text{Powerclass}}$  the peak EIRP as specified in sub-clause 6.2A.1,  $\text{EIRP}_{\text{max}}$  the applicable maximum EIRP as specified in sub-clause 6.2A.1, MPR as specified in sub-clause 6.2A.2, A-MPR as specified in sub-clause 6.2A.3,  $\Delta\text{MB}_{\text{P,n}}$  the peak EIRP relaxation as specified in clause 6.2.1, P-MPR the power management term for the UE as described in 6.2.4.

The measured configured power  $P_{\text{UMAX}}$  for carrier aggregation is defined as

$$P_{\text{UMAX}} = 10 \log_{10} \sum_{c \in f(c)} P_{\text{UMAX},f,c}$$

where  $p_{\text{UMAX},f,c}$  is the linear value of the measured power  $P_{\text{UMAX},f,c}$  for carrier  $f=f(c)$  of serving cell  $c$ . The measured total radiated power  $P_{\text{TMAX}}$  for carrier aggregation is defined as

$$P_{\text{TMAX}} = 10 \log_{10} \sum_{c \in f(c)} P_{\text{TMAX},f,c}$$

where  $p_{\text{TMAX},f,c}$  is the linear value of the measured total radiated power  $P_{\text{TMAX},f,c}$  for carrier  $f=f(c)$  of serving cell  $c$ . The total radiated power  $P_{\text{TMAX}}$  is bounded by

$$P_{\text{TMAX}} \leq \text{TRP}_{\text{max}}$$

where  $\text{TRP}_{\text{max}}$  the maximum TRP for the UE power class as specified in sub-clause 6.2A.1.

The tolerance  $\text{T}(\Delta\text{P})$  for applicable values of  $\Delta\text{P}$  (values in dB) is specified in Table 6.2A.4.0-1.

**Table 6.2A.4.0-1:  $P_{\text{UMAX}}$  tolerance**

Operating Band	$\Delta\text{P}$ (dB)	Tolerance $\text{T}(\Delta\text{P})$ (dB)
n257, n258, n260, n261	$\Delta\text{P} = 0$	0
	$0 < \Delta\text{P} \leq 2$	1.5
	$2 < \Delta\text{P} \leq 3$	2.0
	$3 < \Delta\text{P} \leq 4$	3.0
	$4 < \Delta\text{P} \leq 5$	4.0
	$5 < \Delta\text{P} \leq 10$	5.0
	$10 < \Delta\text{P} \leq 15$	7.0
	$15 < \Delta\text{P} \leq X$	8.0
NOTE: X is the value such that $P_{\text{umax}}$ lower bound, $P_{\text{Powerclass}} - \Delta\text{P} - \text{T}(\Delta\text{P}) =$ minimum output power specified in subclause 6.3A.1		

The normative reference for this requirement is TS 38.101-2 [3] clause 6.2A.4.

## 6.2A.4.1 Configured transmitted power for CA (2UL CA)

### 6.2A.4.1.1 Test purpose

To verify the UE measured configured maximum power  $P_{\text{UMAX}}$  is within the range defined prescribed by the specified nominal maximum output power and tolerance.

#### 6.2A.4.1.2 Test applicability

The requirements of this test are covered in test cases 6.2A.1.1.1 UE maximum output power - EIRP and TRP for CA (2UL CA), 6.2A.2.1 Maximum output power reduction for CA (2UL CA) and 6.2A.3.1 UE maximum output power with additional requirements for CA (2UL CA) to all types of NR UE release 15 and forward supporting 2UL CA.

#### 6.2A.4.1.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.2A.4.0.

#### 6.2A.4.1.4 Test description

This test is covered by clause 6.2A.1.1.1 UE maximum output power - EIRP and TRP for CA (2UL CA), 6.2A.2.1 Maximum output power reduction for CA (2UL CA) and 6.2A.3.1 UE maximum output power with additional requirements for CA (2UL CA).

#### 6.2A.4.1.5 Test requirements

This test is covered by clause 6.2A.1.1.1 UE maximum output power - EIRP and TRP for CA (2UL CA), 6.2A.2.1 Maximum output power reduction for CA (2UL CA) and 6.2A.3.1 UE maximum output power with additional requirements for CA (2UL CA).

#### 6.2A.4.2 Configured transmitted power for CA (3UL CA)

FFS

#### 6.2A.4.3 Configured transmitted power for CA (4UL CA)

FFS

#### 6.2A.4.4 Configured transmitted power for CA (5UL CA)

FFS

#### 6.2A.4.5 Configured transmitted power for CA (6UL CA)

FFS

#### 6.2A.4.6 Configured transmitted power for CA (7UL CA)

FFS

#### 6.2A.4.7 Configured transmitted power for CA (8UL CA)

FFS

## 6.2D Transmit power for UL MIMO

### 6.2D.1 UE maximum output power for UL MIMO

#### 6.2D.1.0 General

The requirements in the following clauses define the maximum output power radiated by the UE with *nrofSRS-Ports* set to 2, for any transmission bandwidth within the channel bandwidth for non-CA configuration, unless otherwise stated. MPR shall be applied as specified in clause 6.2D.2

For the maximum output power requirement for 2-layer UL MIMO operation, a UE shall be configured for 2-layer UL MIMO transmission as specified in Table 6.2D.1.0-1.

**Table 6.2D.1.0-1: UL MIMO configuration**

Transmission scheme	DCI format	Number of layers	TPMI index
Codebook based uplink	DCI format 0_1	2	0

The maximum output power requirement for single layer transmission shall apply to a UE that supports ULFPTx feature and is configured for single layer transmission in its declared full power mode [22, TS 38.213] as specified in Table 6.2D.1.0-2.

**Table 6.2D.1.0-2: PUSCH Configuration for uplink full power transmission (ULFPTx)**

ULFPTx Mode	Transmission scheme	DCI format	Modulation	Number of layers	TPMI index
Mode-1	Codebook based uplink	DCI format 0_1	DFT-s-OFDM, CP-OFDM <sup>1</sup>	1	2
Mode-2	Codebook based uplink	DCI format 0_1	DFT-s-OFDM, CP-OFDM	1	0 or 1 <sup>2</sup>
Mode-full power	Codebook based uplink	DCI format 0_1	DFT-s-OFDM, CP-OFDM	1	0,1
NOTE 1: For PUSCH configured with ULFPTxModes set to Mode-1, all requirements for 1-layer CP-OFDM based modulation in subsection 6.2D are assumed to be met if the requirement for 2-layer UL MIMO has been validated.					
NOTE 2: TPMI index selected shall be based upon the full power TPMI reported by the UE [22, TS 38.213].					

### 6.2D.1.1 UE maximum output power - EIRP and TRP for UL MIMO

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- No test points are defined for 2-layer UL MIMO since there is no configuration satisfying MPR=0dB requirements in RAN4.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2, 4 and 5.
- Test Procedures for EIRP beam peak Extreme Conditions are FFS.

#### 6.2D.1.1.1 Test purpose

To verify that the power of any UE emission shall not exceed specified level for the specified channel bandwidth for UL MIMO under the deployment scenarios where additional requirements are specified.

#### 6.2D.1.1.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports UL MIMO.

#### 6.2D.1.1.3 Minimum conformance requirements

##### 6.2D.1.1.3.1 UE maximum output power for UL MIMO for power class 1

The following requirements define the maximum output power radiated by the PC1 UE. Requirements apply to UEs when configured for 2-layer transmission as well as when configured for single layer uplink full power transmission (ULFPTx), with configuration per clause 6.2D.1.0.

The minimum peak EIRP requirements are found in Table 6.2D.1.1.3.1-1 below. The period of measurement shall be at least one sub frame (1ms). The requirement is verified with the test metric of EIRP (Link=TX beam peak direction, Meas=Link angle). Power class 1 UE is used for fixed wireless access (FWA).

**Table 6.2D.1.1.3.1-1: UE minimum peak EIRP for UL MIMO for power class 1**

Operating band	Min peak EIRP (dBm)
n257	40.0
n258	40.0
n260	38.0
n261	40.0
n262	34.2

NOTE 1: Minimum peak EIRP is defined as the lower limit without tolerance.

**Table 6.2D.1.1.3.1-2: (void)**

The maximum output power values for TRP and EIRP are found in Table 6.2D.1.1.3.1-3 below for UE with UL MIMO. The maximum allowed EIRP is derived from regulatory requirements [8]. The requirements are verified with the test metrics of TRP (Link=TX beam peak direction, Meas=TRP grid) in beam locked mode and EIRP (Link=TX beam peak direction, Meas=Link angle).

**Table 6.2D.1.1.3.1-3: UE maximum output power limits for UL MIMO for power class 1**

Operating band	Max TRP (dBm)	Max EIRP (dBm)
n257	35	55
n258	35	55
n260	35	55
n261	35	55
n262	35	55

The minimum EIRP at the 85<sup>th</sup> percentile of the distribution of radiated power measured over the full sphere around the UE with UL MIMO is defined as the spherical coverage requirement and is found in Table 6.2D.1.1.3.1-4 below. The requirement is verified with the test metric of EIRP (Link=Spherical coverage grid, Meas=Link angle).

**Table 6.2D.1.1.3.1-4: UE spherical coverage for UL MIMO for power class 1**

Operating band	Min EIRP at 85 %-tile CDF (dBm)
n257	32.0
n258	32.0
n260	30.0
n261	32.0
n262	26.0
NOTE 1: Minimum EIRP at 85 %-tile CDF is defined as the lower limit without tolerance.	

#### 6.2D.1.1.3.2 UE maximum output power for UL MIMO for power class 2

The following requirements define the maximum output power radiated by the PC2 UE. Requirements apply to UEs when configured for 2-layer transmission as well as when configured for single layer uplink full power transmission (ULFPTx), with configuration per clause 6.2D.1.0.

The minimum peak EIRP requirements are found in Table 6.2D.1.1.3.2-1 below. The period of measurement shall be at least one sub frame (1ms). The requirement is verified with the test metric of EIRP (Link=TX beam peak direction, Meas=Link angle).

**Table 6.2D.1.1.3.2-1: UE minimum peak EIRP for UL MIMO for power class 2**

Operating band	Min peak EIRP (dBm)
n257	29
n258	29
n261	29
n262	22.9
NOTE 1: Minimum peak EIRP is defined as the lower limit without tolerance.	
NOTE 2: Min Peak EIRP refers to the total EIRP for the UL beams peaks.	

The maximum output power values for TRP and EIRP are found in Table 6.2D.1.1.3.2-2 below. The maximum allowed EIRP is derived from regulatory requirements [8]. The requirements are verified with the test metrics of TRP (Link=TX beam peak direction, Meas=TRP grid) in beam locked mode and EIRP (Link=TX beam peak direction, Meas=Link angle).

**Table 6.2D.1.1.3.2-2: UE maximum output power limits for UL MIMO for power class 2**

Operating band	Max TRP (dBm)	Max EIRP (dBm)
n257	23	43
n258	23	43
n261	23	43
n262	23	43

**Table 6.2D.1.1.3.2-3: (void)**

The minimum EIRP at the 60<sup>th</sup> percentile of the distribution of radiated power measured over the full sphere around the UE is defined as the spherical coverage requirement and is found in Table 6.2D.1.1.3.2-4 below. The requirement is verified with the test metric of EIRP (Link=Spherical coverage grid, Meas=Link angle).

**Table 6.2D.1.1.3.2-4: UE spherical coverage for UL MIMO for power class 2**

Operating band	Min EIRP at 60 %-tile CDF (dBm)
n257	18.0
n258	18.0
n261	18.0
n262	11.0
NOTE 1: Minimum EIRP at 60 %-tile CDF is defined as the lower limit without tolerance	

### 6.2D.1.1.3.3 UE maximum output power for UL MIMO for power class 3

The following requirements define the maximum output power radiated by the PC3 UE.. Requirements apply to UEs when configured for 2-layer transmission as well as when configured for single layer uplink full power transmission (ULFPTx), with configuration per clause 6.2D.1.0.

The minimum peak EIRP requirements are found in Table 6.2D.1.1.3.3-1 below. The period of measurement shall be at least one sub frame (1 ms). The requirement is verified with the test metric of EIRP (Link=TX beam peak direction, Meas=Link angle).

**Table 6.2D.1.1.3.3-1: UE minimum peak EIRP for UL MIMO for power class 3**

Operating band	Min peak EIRP (dBm)
n257	22.4
n258	22.4
n259	18.7
n260	20.6
n261	22.4
n262	16.0
NOTE 1: Minimum peak EIRP is defined as the lower limit without tolerance.	
NOTE 2: Min Peak EIRP refers to the total EIRP for the UL beams peaks.	

The maximum output power values for TRP and EIRP are found in Table 6.2D.1.1.3.3-2 below. The maximum allowed EIRP is derived from regulatory requirements [8]. The requirements are verified with the test metrics of TRP (Link=TX beam peak direction, Meas=TRP grid) in beam locked mode and EIRP (Link=TX beam peak direction, Meas=Link angle).

**Table 6.2D.1.1.3.3-2: UE maximum output power limits for UL MIMO for power class 3**

Operating band	Max TRP (dBm)	Max EIRP (dBm)
n257	23	43
n258	23	43
n259	23	43
n260	23	43
n261	23	43
n262	23	43

**Table 6.2D.1.1.3.3-3: (void)**

The minimum EIRP at the 50<sup>th</sup> percentile of the distribution of radiated power measured over the full sphere around the UE is defined as the spherical coverage requirement and is found in Table 6.2D.1.1.3.3-4 below. The requirement is verified with the test metric of EIRP (Link=spherical coverage grid, Meas=Link angle).

**Table 6.2D.1.1.3.3-4: UE spherical coverage for UL MIMO for power class 3**

Operating band	Min EIRP at 50 %-tile CDF (dBm)
n257	11.5
n258	11.5
n259	5.8
n260	8
n261	11.5
NOTE 1: Minimum EIRP at 50 %-tile CDF is defined as the lower limit without tolerance	
NOTE 2: The requirements in this table are only applicable for UE which supports single band in FR2	

#### 6.2D.1.1.3.4 UE maximum output power for UL MIMO for power class 4

The following requirements define the maximum output power radiated by the PC4 UE. Requirements apply to UEs configured for 2-layer transmission as well as UEs configured for single layer uplink full power transmission (ULFPTx), with configuration per clause 6.2D.1.0.

The minimum peak EIRP requirements are found in Table 6.2D.1.1.3.4-1 below. The period of measurement shall be at least one sub frame (1ms). The requirement is verified with the test metric of EIRP (Link=TX beam peak direction, Meas=Link angle).

**Table 6.2D.1.1.3.4-1: UE minimum peak EIRP for UL MIMO for power class 4**

Operating band	Min peak EIRP (dBm)
n257	34
n258	34
n260	31
n261	34
n262	28.3
NOTE 1: Minimum peak EIRP is defined as the lower limit without tolerance.	
NOTE 2: Min Peak EIRP refers to the total EIRP for the UL beams peaks.	

The maximum output power values for TRP and EIRP are found in Table 6.2D.1.1.3.4-2 below. The maximum allowed EIRP is derived from regulatory requirements [8]. The requirements are verified with the test metrics of TRP (Link=TX beam peak direction, Meas=TRP grid) in beam locked mode and EIRP (Link=TX beam peak direction, Meas=Link angle).

**Table 6.2D.1.1.3.4-2: UE maximum output power limits for UL MIMO for power class 4**

Operating band	Max TRP (dBm)	Max EIRP (dBm)
n257	23	43
n258	23	43
n260	23	43
n261	23	43
n262	23	43

**Table 6.2D.1.1.3.4-3: (void)**

The minimum EIRP at the 20<sup>th</sup> percentile of the distribution of radiated power measured over the full sphere around the UE is defined as the spherical coverage requirement and is found in Table 6.2D.1.1.3.4-4 below. The requirement is verified with the test metric of EIRP (Link=Spherical coverage grid, Meas=Link angle).

**Table 6.2D.1.1.3.4-4: UE spherical coverage for UL MIMO for power class 4**

Operating band	Min EIRP at 20 %-tile CDF (dBm)
n257	25
n258	25
n260	19
n261	25
n262	16.2
NOTE 1: Minimum EIRP at 20 %-tile CDF is defined as the lower limit without tolerance	

The normative reference for this requirement is TS 38.101-2 [3] clause 6.2.1.

#### 6.2D.1.1.3.6 UE maximum output power for UL MIMO for power class 6

The following requirements define the maximum output power radiated by the PC6 UE. Requirements apply to UEs configured for 2-layer transmission as well as UEs configured for single layer uplink full power transmission (ULFPTx), with configuration per clause 6.2D.1.0.

The minimum peak EIRP requirements are found in Table 6.2D.1.1.3.6-1 below. The period of measurement shall be at least one sub frame (1ms). The requirement is verified with the test metric of EIRP (Link=TX beam peak direction, Meas=Link angle).

**Table 6.2D. 1.1.3.6-1: UE minimum peak EIRP for UL MIMO for power class 6**

Operating band	Min peak EIRP (dBm)
n257	30
n258	30.4
n261	30
NOTE 1: Minimum peak EIRP is defined as the lower limit without tolerance	

The maximum output power values for TRP and EIRP are found in Table 6.2D. 1.1.3.6-2 below for UE with UL MIMO. The maximum allowed EIRP is derived from regulatory requirements [8]. The requirements are verified with the test metrics of TRP (Link=TX beam peak direction, Meas=TRP grid) in beam locked mode and EIRP (Link=TX beam peak direction, Meas=Link angle).

**Table 6.2D. 1.1.3.6-2: UE maximum output power limits for UL MIMO for power class 6**

Operating band	Max TRP (dBm)	Max EIRP (dBm)
n257	23	43
n258	23	43
n261	23	43

The minimum EIRP measured over the spherical coverage evaluation areas is defined as the spherical coverage requirement and is found in Table 6.2D. 1.1.3.6-3 below. UE spherical coverage evaluation areas are found in Table 6.2.1.1.3.6-3a in clause 6.2.1.1.3.6, by consisting of Area-1 and Area-2, in the reference coordinate system in Annex J.1. The requirement is verified with the test metric of EIRP (Link= Spherical coverage grid, Meas=Link angle).

**Table 6.2D. 1.1.3.6-3: UE spherical coverage for UL MIMO for power class 6**

Operating band	Min EIRP over UE spherical coverage evaluation areas (dBm)
n257	20
n258	20.4
n261	20



NOTE 1: Minimum EIRP over UE spherical coverage evaluation areas is defined as the lower limit without tolerance

NOTE 2: The requirements in this table are verified only under normal temperature conditions as defined in Annex E.2.1.

NOTE 3: The requirements in this table are applicable to FR2 PC6 UE with the network signalling [*highSpeedMeasFlag-r17*] configured as [*set2*].

6.2D.1.1.4 Test description

6.2D.1.1.4.1 Initial conditions

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, and channel bandwidths based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each channel bandwidth and subcarrier spacing, are shown in Table 6.2D.1.1.4.1-1 and Table 6.2D.1.1.4.1-2. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.2D.1.1.4.1-1: Test Configuration Table for 2-layer UL MIMO**

NOTE: No test points are defined since there is no configuration satisfying MPR=0dB requirements in RAN4.

**Table 6.2D.1.1.4.1-2: Test Configuration Table for uplink full power transmission (ULFPTx)**

Default Conditions					
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal, TL, TH		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1			Low range, Mid Range, High range		
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1			Lowest, 100 MHz, Highest		
Test SCS as specified in Table 5.3.5-1			120 kHz		
Test Parameters					
Test ID	ChBw	SCS	Downlink Configuration	Uplink Configuration	
		Default	N/A	Modulation	RB allocation (NOTE 1)
1	50			DFT-s-OFDM QPSK	Inner_Full for PC2, PC3 and PC4 Inner_Full_Region1 for PC1
2	100				
3	200				
4	400				
NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.					

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement channels are set according to Table 6.2D.1.1.4.1-2.
5. Propagation conditions are set according to Annex B.0
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity NR, Connected without release On, Test Mode On and Test Loop Function On according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.2D.1.1.4.3

## 6.2D.1.1.4.2 Test procedure

1. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.2D.1.1.4.1-2. Since the UL has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC. Messages to configure the appropriate uplink modulation in section 6.2D.1.1.4.3.
2. Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
3. Send continuously uplink power control "up" commands in every uplink scheduling information to the UE; allow at least 200 msec starting from the first TPC command in this step to ensure that the UE transmits at its maximum output power. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
4. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
5. Measure UE EIRP in the Tx beam peak direction in the channel bandwidth of the radio access mode according to the test configuration, which shall meet the requirements described in Tables 6.2D.1.1.5-1 to 6.2D.1.1.5-4. EIRP test procedure is defined in Annex K.1.3. The measuring duration is one active uplink subframe. EIRP is calculated considering both polarizations, theta and phi.
6. Measure TRP of the transmitted signal for the assigned NR channel with a rectangular measurement filter with bandwidths according to Table 6.5.2.3.5-1. Total radiated power is measured according to TRP measurement procedure defined in Annex K.1.7 and measurement grid specified in Annex M.4. TRP is calculated considering both polarizations, theta and phi.
7. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.
8. If UE supports ULFPTx, repeat test steps 1~7 with UL RMC according to Table 6.2D.1.1.4.1-2. The PDCCH DCI format 0\_1 is specified with the condition ULFPTx\_Mode1, ULFPTx\_Mode2 or ULFPTx\_ModeFull in 38.508-1 [5] subclause 4.3.6.1.1.2 depending on UE reported capability. Message contents are according to TS 38.508-1 [5] clause 4.6.3 Table 4.6.3-118 with condition TRANSFORM\_PRECODER\_ENABLED.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

## 6.2D.1.1.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6.

## 6.2D.1.1.5 Test requirement

The EIRP derived in step 4, TRP derived in step 5, and EIRP and TRP derived in step 8 shall not exceed the values specified in Table 6.2D.1.1.5-1 to Table 6.2D.1.1.5-4.

**Table 6.2D.1.1.5-1: UE maximum output test requirements for power class 1**

Operating band	Max TRP (dBm)	Max EIRP (dBm)	Min peak EIRP (dBm)
n257	35+TT	55	40.0-TT
n258	35+TT	55	40.0-TT
n260	35+TT	55	38.0-TT
n261	35+TT	55	40.0-TT
n262	35+TT	55	34.2-TT

**Table 6.2D.1.1.5-2: UE maximum output test requirements for power class 2**

Operating band	Max TRP (dBm)	Max EIRP (dBm)	Min peak EIRP (dBm)
n257	23+TT	43	29-TT
n258	23+TT	43	29-TT
n260			
n261	23+TT	43	29-TT

n262	23+TT	43	22.9-TT
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**Table 6.2D.1.1.5-3: UE maximum output test requirements for power class 3**

Operating band	Max TRP (dBm)	Max EIRP (dBm)	Min peak EIRP (dBm)
n257	23+TT	43	22.4-TT
n258	23+TT	43	22.4-TT
n260	23+TT	43	20.6-TT
n261	23+TT	43	22.4-TT
n262	23+TT	43	16.0-TT

**Table 6.2D.1.1.5-3b: Test Tolerance (Max TRP for Power class 3)**

FFS

**Table 6.2D.1.1.5-3c: Test Tolerance (Min peak EIRP for Power class 3)**

FFS

**Table 6.2D.1.1.5-4: UE maximum output power test requirements for power class 4**

Operating band	Max TRP (dBm)	Max EIRP (dBm)	Min peak EIRP (dBm)
n257	23+TT	43	34-TT
n258	23+TT	43	34-TT
n260	23+TT	43	31-TT
n261	23+TT	43	34-TT

## 6.2D.1.2 UE maximum output power - Spherical coverage for UL MIMO

**Editor's note:** This clause is incomplete. The following aspects are either missing or not yet determined:

- No test points are defined for 2-layer UL MIMO since there is no configuration satisfying MPR=0dB requirements in RAN4.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2, 4 and 5.
- The test case is incomplete for band n259.

### 6.2D.1.2.1 Test purpose

To verify that the spatial coverage of the UE in expected directions is acceptable.

### 6.2D.1.2.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that support beam correspondence without UL beam sweeping.

### 6.2D.1.2.3 Minimum conformance requirements

Minimum conformance requirements are defined in clause 6.2D.1.1.3.

### 6.2D.1.2.4 Test description

#### 6.2D.1.2.4.1 Initial conditions

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, and channel bandwidths based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test

parameters for each channel bandwidth and subcarrier spacing, are shown in Table 6.2D.1.2.4.1-1 and Table 6.2D.1.2.4.1-2. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.2D.1.2.4.1-1: Test Configuration Table for 2-layer UL MIMO**

NOTE: No test points are defined since there is no configuration satisfying MPR=0dB requirements in RAN4.

**Table 6.2D.1.2.4.1-2: Test Configuration Table for uplink full power transmission (ULFPTx)**

Default Conditions					
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1			Low range, Mid Range, High range		
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1			Lowest, Highest		
Test SCS as specified in Table 5.3.5-1			120 kHz		
Test Parameters					
Test ID	ChBw	SCS	Downlink Configuration	Uplink Configuration	
		Default	N/A	Modulation	RB allocation (NOTE 1)
1	50			DFT-s-OFDM QPSK	Inner_Full for PC2, PC3 and PC4 Inner_Full_Region1 for PC1
2	100				
3	200				
4	400				
NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.					

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C.2 and TS 38.508-1 [10] subclause 5.2.1.1.1, and uplink signals according to Annex G.0, G.1 and G.3.0.
4. The UL Reference Measurement channels are set according to Table 6.2D.1.2.4.1-2.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.2D.1.2.4.3

#### 6.2D.1.2.4.2 Test procedure

1. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.2D.1.2.4.1-2. Since the UL has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC. Messages to configure the appropriate uplink modulation in section 6.2D.1.2.4.3.
2. Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
3. Send continuously uplink power control "up" commands in every uplink scheduling information to the UE; allow at least 200 msec to ensure that the UE transmits at its maximum output power. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
4. Through its beam correspondence procedure, DUT refines its TX beam toward that direction depending on DUT's beam correspondence capability which shall match OEM declaration:
  - 4a If the DUT's beam correspondence capability beamCorrespondenceWithoutUL-BeamSweeping is supported, then DUT autonomously chooses the corresponding TX beam for PUSCH transmission using downlink

reference signals to transmit in the direction of the incoming DL signal, which is based on beam correspondence without relying on UL beam sweeping;

- 4b) If the DUT's beam correspondence capability `beamCorrespondenceWithoutUL-BeamSweeping` is not present, then DUT chooses the TX beam for PUSCH transmission which is based on beam correspondence with relying on both DL measurements on downlink reference signals and network-assisted uplink beam sweeping:
- 4b.1) DUT uses downlink reference signals to select proper RX beam and uses autonomous beam correspondence to select the TX beam.
- 4b.2) SS configures  $M=8$  SRS resources to DUT, with the field `spatialRelationInfo` omitted and the field usage set as 'beamManagement'. In case DUT supports less than 8 SRS resources, SS configures the number of SRS resources according to the maximum number of SRS resources indicated by UE capability signalling. Additionally, for codebook based PUSCH transmission, SS configures a semi-persistent SRS resource set with the field `usage` as 'codebook'.
- 4b.3) Based on the TX beam autonomously selected by DUT, DUT chooses TX beams to transmit SRS-resources configured by SS.
- 4b.4) Based on measurement of the received `beamManagement` SRS, SS chooses the best SRS beam and, if needed, updates the spatial relation information between the semi-persistent `codebook` SRS resources and the SS selected `beamManagement` SRS resource in the activation MAC CE of the semi-persistent SRS resource. The SS indicates in the SRS Resource Indicator (SRI) field in the scheduling grant for PUSCH, if present, the SRS resource within the semi-persistent SRS resource set whose spatial relation is linked to the best detected SRS beam.
- 4b.5) DUT transmits PUSCH corresponding to the SRS resource indicated by the SRI.
5. Measure UE EIRP value for each grid point according to the EIRP spherical coverage procedure defined in Annex K.1.5.0, and obtain a cumulative distribution function (CDF) of all EIRP dBm values. Alternatively, UE EIRP measurement for each grid point could be done according to Tx Fast spherical coverage procedure defined in Annex K.1.5.1. After a rotation, allow at least `BEAM_SELECT_WAIT_TIME` (NOTE 1) for UE to find the best beam to use. The measuring duration is one active uplink subframe. EIRP is calculated considering both polarizations, theta and phi.
6. Identify the EIRP dBm value corresponding to %-tile (UE power class dependent) value in the applicable test requirement table in section 6.2D.1.2.5.
7. If UE supports ULFPTx, repeat test steps 1~6 with UL RMC according to Table 6.2D.1.2.4.1-2. The PDCCH DCI format 0\_1 is specified with the condition `ULFPTx_Mode1`, `ULFPTx_Mode2` or `ULFPTx_ModeFull` in 38.508-1 [5] subclause 4.3.6.1.1.2 depending on UE reported capability. Message contents are according to TS 38.508-1 [5] clause 4.6.3 Table 4.6.3-118 with condition `TRANSFORM_PRECODER_ENABLED`.

NOTE 1: The `BEAM_SELECT_WAIT_TIME` default value is defined in Annex K.1.1.

#### 6.2D.1.2.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6.

#### 6.2D.1.2.5 Test requirement

The defined %-tile EIRP in measurement distribution derived in step 5 and step 6 shall exceed the values specified in Table 6.2D.1.2.5-1 to Table 6.2D.1.2.5-4.

**Table 6.2D.1.2.5-1: UE spherical coverage for power class 1**

Operating band	Min EIRP at 85%-tile CDF (dBm)
n257	32.0-TT
n258	32.0-TT
n260	30.0-TT
n261	32.0-TT
n262	26.0-TT

**Table 6.2D.1.2.5-2: UE spherical coverage for power class 2**

Operating band	Min EIRP at 60%-tile CDF (dBm)
n257	18.0-TT
n258	18.0-TT
n260	
n261	18.0-TT
n262	11.0-TT

**Table 6.2D.1.2.5-3: UE spherical coverage for power class 3**

Operating band	Min EIRP at 50%-tile CDF (dBm)
n257	11.5-TT
n258	11.5-TT
n259	5.8-TT
n260	8-TT
n261	11.5-TT

**Table 6.2D.1.2.5-3b: Test Tolerance (UE spherical coverage for Power class 3)**

FFS

**Table 6.2D.1.2.5-4: UE spherical coverage for power class 4**

Operating band	Min EIRP at 20%-tile CDF (dBm)
n257	25-TT
n258	25-TT
n260	19-TT
n261	25-TT
n262	16.2-TT

## 6.2D.2 UE maximum output power reduction for UL MIMO

Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:

- OTA test procedure for UL MIMO is still under investigation
- Measurement Uncertainties and Test Tolerances are FFS.

### 6.2D.2.1 Test purpose

The number of RB identified in 6.2D.2.3 is based on meeting the requirements for the maximum power reduction (MPR) due to Cubic Metric (CM).

### 6.2D.2.2 Test applicability

This test case applies to all types of NR UE release 15 and forward supporting UL MIMO.

### 6.2D.2.3 Minimum conformance requirements

#### 6.2D.2.3.1 UE maximum output power reduction for modulation / channel bandwidth for UL MIMO for power class 1

For UEs configured for 2-layer transmission as well as UEs configured for single layer uplink full power transmission (ULFPTx), the allowed Maximum Power Reduction (MPR) for the maximum output power in Table 6.2D.1.1.3.1-1 is specified in sub-clause 6.2.2.3.1. The requirements shall be met with configurations specified in sub-clause 6.2D.1.0.

For the UE maximum output power modified by MPR, the power limits specified in clause 6.2D.4 apply.

### 6.2D.2.3.2 UE maximum output power reduction for modulation / channel bandwidth for UL MIMO for power class 2

For UEs configured for 2-layer transmission as well as UEs configured for single layer uplink full power transmission (ULFPTx), the allowed Maximum Power Reduction (MPR) for the maximum output power in Table 6.2D.1.1.3.2-1 is specified in sub-clause 6.2.2.3.2. The requirements shall be met with configurations specified in sub-clause 6.2D.1.0.

For the UE maximum output power modified by MPR, the power limits specified in clause 6.2D.4 apply.

### 6.2D.2.3.3 UE maximum output power reduction for modulation / channel bandwidth for UL MIMO for power class 3

For UEs configured for 2-layer transmission as well as UEs configured for single layer uplink full power transmission (ULFPTx), the allowed Maximum Power Reduction (MPR) for the maximum output power in Table 6.2D.1.1.3.3-1 is specified in sub-clause 6.2.2.3.3. The requirements shall be met with configurations specified in sub-clause 6.2D.1.0.

For the UE maximum output power modified by MPR, the power limits specified in clause 6.2D.4 apply.

### 6.2D.2.3.4 UE maximum output power reduction for modulation / channel bandwidth for UL MIMO for power class 4

For UEs configured for 2-layer transmission as well as UEs configured for single layer uplink full power transmission (ULFPTx), the allowed Maximum Power Reduction (MPR) for the maximum output power in Table 6.2D.1.1.3.4-1 is specified in sub-clause 6.2.2.3.4. The requirements shall be met with configurations specified in sub-clause 6.2D.1.0.

For the UE maximum output power modified by MPR, the power limits specified in clause 6.2D.4 apply.

### 6.2D.2.3.5 UE maximum output power reduction for modulation / channel bandwidth for UL MIMO for power class 5

For UEs configured for 2-layer transmission as well as UEs configured for single layer uplink full power transmission (ULFPTx), the allowed Maximum Power Reduction (MPR) for the maximum output power in Table 6.2D.1.1.3.4-1 is specified in sub-clause 6.2.2.3.4. The requirements shall be met with configurations specified in sub-clause 6.2D.1.0.

For the UE maximum output power modified by MPR, the power limits specified in clause 6.2D.4 apply.

The normative reference for this requirement is TS 38.101-2 [3] clause 6.2D.2.

## 6.2D.2.4 Test description

### 6.2D.2.4.1 Initial condition

Same initial condition in clause 6.2.2.4.1, with following exceptions:

- Instead of Table 6.2.2.4.1-1 → use Table 6.2D.2.4.1-1.
- Instead of Table 6.2.2.4.1-2 → use Table 6.2D.2.4.1-2.
- Instead of Table 6.2.2.4.1-3 → use Table 6.2D.2.4.1-3.
- Instead of Table 6.2.2.4.1-7 → use Table 6.2D.2.4.1-4.
- Instead of Table 6.2.2.4.1-8 → use Table 6.2D.2.4.1-5.
- Instead of Table 6.2.2.4.1-9 → use Table 6.2D.2.4.1-6.

**Table 6.2D.2.4.1-1: Test Configuration Table (Power Class 1, MPR<sub>narrow</sub>)**

Default Conditions	
Test Environment as specified in TS 38.508-1 [10] subclause 4.1	Normal, TL, TH

Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1		Low range, High range																	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1		Lowest and Highest																	
Test SCS as specified in Table 5.3.5-1		Lowest, Highest																	
Test Parameters																			
Test ID	Freq	ChBw	SCS	Downlink Configuration	Uplink Configuration														
		Default	Default	-	<table border="1"> <thead> <tr> <th>Modulation</th> <th>RB allocation (NOTE 1)</th> </tr> </thead> <tbody> <tr> <td>CP-OFDM 64 QAM</td> <td>Outer_1RB_Left</td> </tr> <tr> <td>CP-OFDM 64 QAM</td> <td>Outer_1RB_Right</td> </tr> <tr> <td>CP-OFDM 64 QAM</td> <td>2@0</td> </tr> <tr> <td>CP-OFDM 64 QAM</td> <td>2@NRB-2</td> </tr> <tr> <td>CP-OFDM 64 QAM</td> <td>7@0</td> </tr> <tr> <td>CP-OFDM 64 QAM</td> <td>7@NRB-7</td> </tr> </tbody> </table>	Modulation	RB allocation (NOTE 1)	CP-OFDM 64 QAM	Outer_1RB_Left	CP-OFDM 64 QAM	Outer_1RB_Right	CP-OFDM 64 QAM	2@0	CP-OFDM 64 QAM	2@NRB-2	CP-OFDM 64 QAM	7@0	CP-OFDM 64 QAM	7@NRB-7
Modulation	RB allocation (NOTE 1)																		
CP-OFDM 64 QAM	Outer_1RB_Left																		
CP-OFDM 64 QAM	Outer_1RB_Right																		
CP-OFDM 64 QAM	2@0																		
CP-OFDM 64 QAM	2@NRB-2																		
CP-OFDM 64 QAM	7@0																		
CP-OFDM 64 QAM	7@NRB-7																		
1	Low																		
2	High																		
3	Low																		
4	High																		
5	Low																		
6	High																		
NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-2.																			

**Table 6.2D.2.4.1-2: Test Configuration Table (Power Class 1, MPR<sub>WT</sub>, BW<sub>channel</sub> ≤ 200 MHz)**

Default Conditions																															
Test Environment as specified in TS 38.508-1 [10] subclause 4.1		Normal, TL, TH																													
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1		Low range, Mid range, High range																													
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1		Lowest and Highest supported channel bandwidth that ≤ 200 MHz																													
Test SCS as specified in Table 5.3.5-1		Lowest, Highest																													
Test Parameters																															
Test ID	Freq	ChBw	SCS	Downlink Configuration	Uplink Configuration																										
		Default	Default	-	<table border="1"> <thead> <tr> <th>Modulation</th> <th>RB allocation (NOTE 1)</th> </tr> </thead> <tbody> <tr> <td>CP-OFDM QPSK</td> <td>Inner_Full_Region2</td> </tr> <tr> <td>CP-OFDM QPSK</td> <td>8@0</td> </tr> <tr> <td>CP-OFDM QPSK</td> <td>8@NRB-8</td> </tr> <tr> <td>CP-OFDM QPSK</td> <td>Outer_Full</td> </tr> <tr> <td>CP-OFDM 16 QAM</td> <td>8@0</td> </tr> <tr> <td>CP-OFDM 16 QAM</td> <td>8@NRB-8</td> </tr> <tr> <td>CP-OFDM 16 QAM</td> <td>Outer_Full</td> </tr> <tr> <td>CP-OFDM 16 QAM</td> <td>Inner_Full_Region2</td> </tr> <tr> <td>CP-OFDM 64 QAM</td> <td>8@0</td> </tr> <tr> <td>CP-OFDM 64 QAM</td> <td>8@NRB-8</td> </tr> <tr> <td>CP-OFDM 64 QAM</td> <td>Outer_Full</td> </tr> <tr> <td>CP-OFDM 64 QAM</td> <td>Inner_Full</td> </tr> </tbody> </table>	Modulation	RB allocation (NOTE 1)	CP-OFDM QPSK	Inner_Full_Region2	CP-OFDM QPSK	8@0	CP-OFDM QPSK	8@NRB-8	CP-OFDM QPSK	Outer_Full	CP-OFDM 16 QAM	8@0	CP-OFDM 16 QAM	8@NRB-8	CP-OFDM 16 QAM	Outer_Full	CP-OFDM 16 QAM	Inner_Full_Region2	CP-OFDM 64 QAM	8@0	CP-OFDM 64 QAM	8@NRB-8	CP-OFDM 64 QAM	Outer_Full	CP-OFDM 64 QAM	Inner_Full
Modulation	RB allocation (NOTE 1)																														
CP-OFDM QPSK	Inner_Full_Region2																														
CP-OFDM QPSK	8@0																														
CP-OFDM QPSK	8@NRB-8																														
CP-OFDM QPSK	Outer_Full																														
CP-OFDM 16 QAM	8@0																														
CP-OFDM 16 QAM	8@NRB-8																														
CP-OFDM 16 QAM	Outer_Full																														
CP-OFDM 16 QAM	Inner_Full_Region2																														
CP-OFDM 64 QAM	8@0																														
CP-OFDM 64 QAM	8@NRB-8																														
CP-OFDM 64 QAM	Outer_Full																														
CP-OFDM 64 QAM	Inner_Full																														
1	Mid																														
2	Low																														
3	High																														
4	Mid																														
5	Low																														
6	High																														
7	Mid																														
8	Mid																														
9	Low																														
10	High																														
11	Mid																														
12	Mid																														
NOTE 1: The specific configuration of each RF allocation is defined in clause 6.1-2.																															

**Table 6.2D.2.4.1-3: Test Configuration Table (Power Class 1, MPR<sub>WT</sub>, BW<sub>channel</sub> = 400 MHz)**

Default Conditions	
Test Environment as specified in TS 38.508-1 [10] subclause 4.1	Normal, TL, TH
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1	Low range, Mid range, High range
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1	400 MHz



Test SCS as specified in Table 5.3.5-1					120kHz	
Test Parameters						
Test ID	Freq	ChBw	SCS	Downlink Configuration	Uplink Configuration	
		Default	Default	-	Modulation	RB allocation (NOTE 1)
1	Mid				CP-OFDM QPSK	Inner_Full_Region2
2	Low				CP-OFDM QPSK	8@0
3	High				CP-OFDM QPSK	8@N <sub>RB</sub> -8
4	Mid				CP-OFDM QPSK	Outer_Full
5	Low				CP-OFDM 16 QAM	8@0
6	High				CP-OFDM 16 QAM	8@N <sub>RB</sub> -8
7	Mid				CP-OFDM 16 QAM	Outer_Full
8	Mid				CP-OFDM 16 QAM	Inner_Full_Region2
9	Low				CP-OFDM 64 QAM	8@0
10	High				CP-OFDM 64 QAM	8@N <sub>RB</sub> -8
11	Mid	CP-OFDM 64 QAM	Outer_Full			
NOTE 1: The specific configuration of each RF allocation is defined in clause 6.1-2.						

**Table 6.2D.2.4.1-4: Test Configuration Table (Power Class 2, 3 and 4, MPR<sub>narrow</sub>, BWchannel ≤ 200 MHz)**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1					Normal, TL, TH	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1					Low range, High range	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1					Lowest and Highest supported channel bandwidth that ≤ 200 MHz t	
Test SCS as specified in Table 5.3.5-1					Lowest, Highest	
Test Parameters						
Test ID	Freq	ChBw	SCS	Downlink Configuration	Uplink Configuration	
		Default	Default	-	Modulation	RB allocation (NOTE 1)
1	Low				CP-OFDM QPSK	Outer_1RB_Left
2	High				CP-OFDM QPSK	Outer_1RB_Right
NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-1.						

**Table 6.2D.2.4.1-5: Test Configuration Table (Power Class 2, 3 and 4, MPR<sub>WT</sub>, BWchannel ≤ 200 MHz)**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1					Normal, TL, TH	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1					Low range, Mid range, High range	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1					Lowest and Highest supported channel bandwidth that ≤ 200 MHz	
Test SCS as specified in Table 5.3.5-1					Lowest, Highest	
Test Parameters						
Test ID	Freq	ChBw	SCS	Downlink Configuration	Uplink Configuration	
		Default	Default	-	Modulation	RB allocation (NOTE 1)
1	Mid				CP-OFDM QPSK	Inner_Full
2	Low				CP-OFDM QPSK	Outer_1RB_Left

3	High				CP-OFDM QPSK	Outer_1RB_Right
4	Mid				CP-OFDM QPSK	Outer_Full
5	Mid				CP-OFDM 16 QAM	Inner_Full
6	Low				CP-OFDM 16 QAM	Outer_1RB_Left
7	High				CP-OFDM 16 QAM	Outer_1RB_Right
8	Mid				CP-OFDM 16 QAM	Outer_Full
9	Mid				CP-OFDM 64 QAM	Inner_Full
10	Low				CP-OFDM 64 QAM	Outer_1RB_Left
11	High				CP-OFDM 64 QAM	Outer_1RB_Right
12	Mid				CP-OFDM 64 QAM	Outer_Full
NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-1.						

**Table 6.2D.2.4.1-6: Test Configuration Table (Power Class 2, 3 and 4, MPR<sub>WT</sub>, BW<sub>channel</sub> = 400 MHz)**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1					Normal, TL, TH	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1					Low range, High range	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1					400 MHz	
Test SCS as specified in Table 5.3.5-1					120kHz	
Test Parameters						
Test ID	Freq	ChBw	SCS	Downlink Configuration	Uplink Configuration	
					Modulation	RB allocation (NOTE 1)
1	Low	Default	Default	-	CP-OFDM QPSK	Outer_1RB_Left
2	High				CP-OFDM QPSK	Outer_1RB_Right
3	Mid				CP-OFDM QPSK	Outer_Full
4	Low				CP-OFDM 16 QAM	Outer_1RB_Left
5	High				CP-OFDM 16 QAM	Outer_1RB_Right
6	Mid				CP-OFDM 16 QAM	Outer_Full
7	Low				CP-OFDM 64 QAM	Outer_1RB_Left
8	High				CP-OFDM 64 QAM	Outer_1RB_Right
9	Mid				CP-OFDM 64 QAM	Outer_Full
NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-1.						

**Table 6.2D.2.4.1-7: Test Configuration Table for ULFP<sub>Tx</sub> (Power Class 1, MPR<sub>narrow</sub>)**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1					Normal, TL, TH	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1					Low range, High range	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1					Lowest and Highest	
Test SCS as specified in Table 5.3.5-1					Lowest, Highest	
Test Parameters						
Test ID	Freq	ChBw	SCS	Downlink Configuration	Uplink Configuration	
					Modulation	RB allocation (NOTE 1)
1	Low	Default	Default	N/A for Maximum Power Reduction (MPR) test case	CP-OFDM 64 QAM	Outer_1RB_Left
2	High				CP-OFDM 64 QAM	Outer_1RB_Right
3	Low				CP-OFDM 64 QAM	2@0
4	High				CP-OFDM 64 QAM	2@N <sub>RB</sub> -2
5	Low				CP-OFDM 64 QAM	7@0
6	High				CP-OFDM 64 QAM	7@N <sub>RB</sub> -7
NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-2.						
NOTE 2: Test IDs 1 ~ 6 with CP-OFDM modulation are not needed if PDCCH DCI format 0_1 indicates ULFP <sub>Tx</sub> _Mode1.						

**Table 6.2D.2.4.1-8: Test Configuration Table for ULFP Tx (Power Class 1,  $MPR_{WT}$ ,  $BW_{channel} \leq 200$  MHz)**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal, TL, TH		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1				Low range, Mid range, High range		
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1				Lowest and Highest supported channel bandwidth that $\leq 200$ MHz		
Test SCS as specified in Table 5.3.5-1				Lowest, Highest		
Test Parameters						
Test ID	Freq	ChBw	SCS	Downlink Configuration	Uplink Configuration	
					Modulation	RB allocation (NOTE 1)
1	Low	Default	Default	N/A for Maximum Power Reduction (MPR) test case	DFT-s-OFDM PI/2 BPSK	8@0
2	High				DFT-s-OFDM PI/2 BPSK	8@N <sub>RB</sub> -8
3	Mid				DFT-s-OFDM PI/2 BPSK	Outer_Full
4	Mid				DFT-s-OFDM QPSK	Inner_Full_Region2
5	Low				DFT-s-OFDM QPSK	8@0
6	High				DFT-s-OFDM QPSK	8@N <sub>RB</sub> -8
7	Mid				DFT-s-OFDM QPSK	Outer_Full
8	Mid				DFT-s-OFDM 16 QAM	Inner_Full_Region2
9	Low				DFT-s-OFDM 16 QAM	8@0
10	High				DFT-s-OFDM 16 QAM	8@N <sub>RB</sub> -8
11	Mid				DFT-s-OFDM 16 QAM	Outer_Full
12	Low				DFT-s-OFDM 64 QAM	8@0
13	High				DFT-s-OFDM 64 QAM	8@N <sub>RB</sub> -8
14	Mid				DFT-s-OFDM 64 QAM	Outer_Full
15	Mid				DFT-s-OFDM 64 QAM	Inner_Full_Region2
16	Mid				CP-OFDM QPSK	Inner_Full_Region2
17	Low				CP-OFDM QPSK	8@0
18	High				CP-OFDM QPSK	8@N <sub>RB</sub> -8
19	Mid				CP-OFDM QPSK	Outer_Full
20	Low				CP-OFDM 16 QAM	8@0
21	High				CP-OFDM 16 QAM	8@N <sub>RB</sub> -8
22	Mid				CP-OFDM 16 QAM	Outer_Full
23	Mid				CP-OFDM 16 QAM	Inner_Full_Region2
24	Low				CP-OFDM 64 QAM	8@0
25	High				CP-OFDM 64 QAM	8@N <sub>RB</sub> -8
26	Mid				CP-OFDM 64 QAM	Outer_Full

NOTE 1: The specific configuration of each RF allocation is defined in clause 6.1-2.  
 NOTE 2: Test IDs 16 ~ 26 with CP-OFDM modulation are not needed if PDCCH DCI format 0\_1 indicates ULFP Tx\_Mode1.

**Table 6.2D.2.4.1-9: Test Configuration Table for ULFPTx (Power Class 1, MPR<sub>WT</sub>, BW<sub>channel</sub> = 400 MHz)**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal, TL, TH		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1				Low range, Mid range, High range		
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1				400 MHz		
Test SCS as specified in Table 5.3.5-1				120kHz		
Test Parameters						
Test ID	Freq	ChBw	SCS	Downlink Configuration	Uplink Configuration	
					Modulation	RB allocation (NOTE 1)
1	Low	Default	Default	N/A for Maximum Power Reduction (MPR) test case	DFT-s-OFDM PI/2 BPSK	8@0
2	High				DFT-s-OFDM PI/2 BPSK	8@N <sub>RB</sub> -8
3	Mid				DFT-s-OFDM PI/2 BPSK	Outer_Full
4	Mid				DFT-s-OFDM PI/2 BPSK	Inner_Full_Region2
5	Mid				DFT-s-OFDM QPSK	Inner_Full_Region2
6	Low				DFT-s-OFDM QPSK	8@0
7	High				DFT-s-OFDM QPSK	8@N <sub>RB</sub> -8
8	Mid				DFT-s-OFDM QPSK	Outer_Full
9	Mid				DFT-s-OFDM 16 QAM	Inner_Full_Region2
10	Low				DFT-s-OFDM 16 QAM	8@0
11	High				DFT-s-OFDM 16 QAM	8@N <sub>RB</sub> -8
12	Mid				DFT-s-OFDM 16 QAM	Outer_Full
13	Low				DFT-s-OFDM 64 QAM	8@0
14	High				DFT-s-OFDM 64 QAM	8@N <sub>RB</sub> -8
15	Mid				DFT-s-OFDM 64 QAM	Outer_Full
16	Mid				CP-OFDM QPSK	Inner_Full_Region2
17	Low				CP-OFDM QPSK	8@0
18	High				CP-OFDM QPSK	8@N <sub>RB</sub> -8
19	Mid				CP-OFDM QPSK	Outer_Full
20	Low				CP-OFDM 16 QAM	8@0
21	High				CP-OFDM 16 QAM	8@N <sub>RB</sub> -8
22	Mid				CP-OFDM 16 QAM	Outer_Full
23	Mid				CP-OFDM 16 QAM	Inner_Full_Region2
24	Low				CP-OFDM 64 QAM	8@0
25	High				CP-OFDM 64 QAM	8@N <sub>RB</sub> -8
26	Mid				CP-OFDM 64 QAM	Outer_Full
NOTE 1: The specific configuration of each RF allocation is defined in clause 6.1-2.						
NOTE 2: Test IDs 16 ~ 26 with CP-OFDM modulation are not needed if PDCCH DCI format 0_1 indicates ULFPTx_Mode1.						

**Table 6.2D.2.4.1-10: Test Configuration Table for ULFPTx (Power Class 2, 3 and 4, MPR<sub>narrow</sub>, BW<sub>channel</sub> ≤ 200 MHz)**

Default Conditions						
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Test Environment as specified in TS 38.508-1 [10] subclause 4.1		Normal, TL, TH				
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1		Low range, High range				
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1		Lowest and Highest supported channel bandwidth that ≤ 200 MHz				
Test SCS as specified in Table 5.3.5-1		Lowest, Highest				
Test Parameters						
Test ID	Freq	ChBw	SCS	Downlink Configuration	Uplink Configuration	
		Default	Default	N/A for Maximum Power Reduction (MPR) test case	Modulation	RB allocation (NOTE 1)
1	Low				DFT-s-OFDM PI/2 BPSK	Outer_1RB_Left
2	High				DFT-s-OFDM PI/2 BPSK	Outer_1RB_Right
3	Low				DFT-s-OFDM QPSK	Outer_1RB_Left
4	High				DFT-s-OFDM QPSK	Outer_1RB_Right
NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-1.						

**Table 6.2D.2.4.1-11: Test Configuration Table for ULFP Tx (Power Class 2, 3 and 4, MPR<sub>WT</sub>, BW<sub>channel</sub> ≤ 200 MHz)**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1		Normal, TL, TH				
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1		Low range, Mid range, High range				
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1		Lowest and Highest supported channel bandwidth that ≤ 200 MHz				
Test SCS as specified in Table 5.3.5-1		Lowest, Highest				
Test Parameters						
Test ID	Freq	ChBw	SCS	Downlink Configuration	Uplink Configuration	
		Default	Default	N/A for Maximum Power Reduction (MPR) test case	Modulation	RB allocation (NOTE 1)
1	Mid				DFT-s-OFDM PI/2 BPSK	Outer_Full
2	Mid				DFT-s-OFDM QPSK	Outer_Full
3	Mid				DFT-s-OFDM 16 QAM	Inner_Full
4	Low				DFT-s-OFDM 16 QAM	Outer_1RB_Left
5	High				DFT-s-OFDM 16 QAM	Outer_1RB_Right
6	Mid				DFT-s-OFDM 16 QAM	Outer_Full
7	Mid				DFT-s-OFDM 64 QAM	Inner_Full
8	Low				DFT-s-OFDM 64 QAM	Outer_1RB_Left
9	High				DFT-s-OFDM 64 QAM	Outer_1RB_Right
10	Mid				DFT-s-OFDM 64 QAM	Outer_Full
11	Mid				CP-OFDM QPSK	Inner_Full
12	Low				CP-OFDM QPSK	Outer_1RB_Left
13	High				CP-OFDM QPSK	Outer_1RB_Right
14	Mid				CP-OFDM QPSK	Outer_Full
15	Low				CP-OFDM 16 QAM	Outer_1RB_Left
16	High				CP-OFDM 16 QAM	Outer_1RB_Right
17	Mid				CP-OFDM 16 QAM	Outer_Full
18	Low				CP-OFDM 64 QAM	Outer_1RB_Left
19	High				CP-OFDM 64 QAM	Outer_1RB_Right
20	Mid	CP-OFDM 64 QAM	Outer_Full			
NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-1.						
NOTE 2: Test IDs 11 ~ 20 with CP-OFDM modulation are not needed if PDCCH DCI format 0_1 indicates ULFP Tx_Mode1.						

**Table 6.2D.2.4.1-12: Test Configuration Table for ULFP Tx (Power Class 2, 3 and 4, MPR<sub>WT</sub>, BW<sub>channel</sub> = 400 MHz)**

Default Conditions	
Test Environment as specified in TS 38.508-1 [10] subclause 4.1	Normal, TL, TH

Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1		Low range, High range																																															
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1		400 MHz																																															
Test SCS as specified in Table 5.3.5-1		120kHz																																															
Test Parameters																																																	
Test ID	Freq	ChBw	SCS	Downlink Configuration	Uplink Configuration																																												
					<table border="1"> <thead> <tr> <th>Modulation</th> <th>RB allocation (NOTE 1)</th> </tr> </thead> <tbody> <tr><td>DFT-s-OFDM PI/2 BPSK</td><td>Outer_1RB_Left</td></tr> <tr><td>DFT-s-OFDM PI/2 BPSK</td><td>Outer_1RB_Right</td></tr> <tr><td>DFT-s-OFDM PI/2 BPSK</td><td>Outer_Full</td></tr> <tr><td>DFT-s-OFDM QPSK</td><td>Outer_1RB_Left</td></tr> <tr><td>DFT-s-OFDM QPSK</td><td>Outer_1RB_Right</td></tr> <tr><td>DFT-s-OFDM QPSK</td><td>Outer_Full</td></tr> <tr><td>DFT-s-OFDM 16 QAM</td><td>Outer_1RB_Left</td></tr> <tr><td>DFT-s-OFDM 16 QAM</td><td>Outer_1RB_Right</td></tr> <tr><td>DFT-s-OFDM 16 QAM</td><td>Outer_Full</td></tr> <tr><td>DFT-s-OFDM 64 QAM</td><td>Outer_1RB_Left</td></tr> <tr><td>DFT-s-OFDM 64 QAM</td><td>Outer_1RB_Right</td></tr> <tr><td>DFT-s-OFDM 64 QAM</td><td>Outer_Full</td></tr> <tr><td>CP-OFDM QPSK</td><td>Outer_1RB_Left</td></tr> <tr><td>CP-OFDM QPSK</td><td>Outer_1RB_Right</td></tr> <tr><td>CP-OFDM QPSK</td><td>Outer_Full</td></tr> <tr><td>CP-OFDM 16 QAM</td><td>Outer_1RB_Left</td></tr> <tr><td>CP-OFDM 16 QAM</td><td>Outer_1RB_Right</td></tr> <tr><td>CP-OFDM 16 QAM</td><td>Outer_Full</td></tr> <tr><td>CP-OFDM 64 QAM</td><td>Outer_1RB_Left</td></tr> <tr><td>CP-OFDM 64 QAM</td><td>Outer_1RB_Right</td></tr> <tr><td>CP-OFDM 64 QAM</td><td>Outer_Full</td></tr> </tbody> </table>	Modulation	RB allocation (NOTE 1)	DFT-s-OFDM PI/2 BPSK	Outer_1RB_Left	DFT-s-OFDM PI/2 BPSK	Outer_1RB_Right	DFT-s-OFDM PI/2 BPSK	Outer_Full	DFT-s-OFDM QPSK	Outer_1RB_Left	DFT-s-OFDM QPSK	Outer_1RB_Right	DFT-s-OFDM QPSK	Outer_Full	DFT-s-OFDM 16 QAM	Outer_1RB_Left	DFT-s-OFDM 16 QAM	Outer_1RB_Right	DFT-s-OFDM 16 QAM	Outer_Full	DFT-s-OFDM 64 QAM	Outer_1RB_Left	DFT-s-OFDM 64 QAM	Outer_1RB_Right	DFT-s-OFDM 64 QAM	Outer_Full	CP-OFDM QPSK	Outer_1RB_Left	CP-OFDM QPSK	Outer_1RB_Right	CP-OFDM QPSK	Outer_Full	CP-OFDM 16 QAM	Outer_1RB_Left	CP-OFDM 16 QAM	Outer_1RB_Right	CP-OFDM 16 QAM	Outer_Full	CP-OFDM 64 QAM	Outer_1RB_Left	CP-OFDM 64 QAM	Outer_1RB_Right	CP-OFDM 64 QAM	Outer_Full
Modulation	RB allocation (NOTE 1)																																																
DFT-s-OFDM PI/2 BPSK	Outer_1RB_Left																																																
DFT-s-OFDM PI/2 BPSK	Outer_1RB_Right																																																
DFT-s-OFDM PI/2 BPSK	Outer_Full																																																
DFT-s-OFDM QPSK	Outer_1RB_Left																																																
DFT-s-OFDM QPSK	Outer_1RB_Right																																																
DFT-s-OFDM QPSK	Outer_Full																																																
DFT-s-OFDM 16 QAM	Outer_1RB_Left																																																
DFT-s-OFDM 16 QAM	Outer_1RB_Right																																																
DFT-s-OFDM 16 QAM	Outer_Full																																																
DFT-s-OFDM 64 QAM	Outer_1RB_Left																																																
DFT-s-OFDM 64 QAM	Outer_1RB_Right																																																
DFT-s-OFDM 64 QAM	Outer_Full																																																
CP-OFDM QPSK	Outer_1RB_Left																																																
CP-OFDM QPSK	Outer_1RB_Right																																																
CP-OFDM QPSK	Outer_Full																																																
CP-OFDM 16 QAM	Outer_1RB_Left																																																
CP-OFDM 16 QAM	Outer_1RB_Right																																																
CP-OFDM 16 QAM	Outer_Full																																																
CP-OFDM 64 QAM	Outer_1RB_Left																																																
CP-OFDM 64 QAM	Outer_1RB_Right																																																
CP-OFDM 64 QAM	Outer_Full																																																
1	Low	Default	Default	N/A for Maximum Power Reduction (MPR) test case																																													
2	High																																																
3	Mid																																																
4	Low																																																
5	High																																																
6	Mid																																																
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17	High																																																
18	Mid																																																
19	Low																																																
20	High																																																
21	Mid																																																
NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-1.																																																	
NOTE 2: Test IDs 13 ~ 21 with CP-OFDM modulation are not needed if PDCCH DCI format 0_1 indicates ULFPTx_Mode1.																																																	

6.2D.2.4.2 Test procedure

1. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.2.2.4.1-1 to Table 6.2.2.4.1-9. Since the UL has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC.
2. Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
3. Send continuously uplink power control "up" commands in every uplink scheduling information to the UE; allow at least 200ms for the UE to reach P<sub>UMAX</sub> level. Allow at least BEAM\_SELECT\_WAIT\_TIME (Note 1) for the UE Tx beam selection to complete.
4. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
5. Measure UE EIRP in the Tx beam peak direction in the channel bandwidth of the radio access mode according to the test configuration, which shall meet the requirements described in 6.2.2.5. EIRP test procedure is defined in Annex K.1.3. The measuring duration is one active uplink subframe. EIRP is calculated considering both polarizations, theta and phi.
6. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.
7. If UE supports ULFPTx, repeat test steps 1~6 with UL RMC according to Table 6.2D.2.4.1-7 through Table 6.2D.2.4.1-12. The PDCCH DCI format 0\_1 is specified with the condition ULFPTx\_Mode1, ULFPTx\_Mode2 or ULFPTx\_ModeFull in 38.508-1 [5] subclause 4.3.6.1.1.2 depending on UE reported capability. Message contents are according to TS 38.508-1 [5] clause 4.6.3 Table 4.6.3-118 with condition TRANSFORM\_PRECODER\_ENABLED.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

NOTE 2: When switching to DFT-s-OFDM waveform, as specified in the test configuration table 6.2.2.4.1-1 to Table 6.2.2.4.1-9, send an NR RRCReconfiguration message according to TS 38.508-1 [10] clause 4.6.3 Table 4.6.3-118 PUSCH-Config with TRANSFORM\_PRECODER\_ENABLED condition.

6.2D.2.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 ensuring Table 4.6.3-182 with condition 2TX\_UL\_MIMO.

6.2D.2.5 Test requirements

The maximum output power, derived in step 5 shall be within the range prescribed by the nominal maximum output power and tolerance in following tables.

**Table 6.2D.2.5-1: UE Power Class test requirements for Power Class 1 (for Bands n257, n258, n261)**

FFS

**Table 6.2D.2.5-2: UE Power Class test requirements for Power Class 1 (for Bands n260)**

FFS

**Table 6.2D.2.5-3: UE Power Class test requirements for Power Class 2 (n257, 258, 261)**

FFS

**Table 6.2D.2.5-4: UE Power Class test requirements for Power Class 3 (n257, 258, 261)**

Test Configuration Table	Test ID	BW (MHz)	P <sub>Powerclass</sub>	MPR <sub>f,c</sub>	T(MPR <sub>f,c</sub> )	Lower limit (dBm)	Upper limit (dBm)
Table 6.2D.2.4.1-4	1	<=200MHz	22.4	4.0	3	15.4-TT-ΔMB <sub>P,n</sub>	43
		400MHz	22.4	5.0	4	13.4-TT-ΔMB <sub>P,n</sub>	43
	2	<=200MHz	22.4	4.0	3	15.4-TT-ΔMB <sub>P,n</sub>	43
		400MHz	22.4	5.0	4	13.4-TT-ΔMB <sub>P,n</sub>	43
Table 6.2D.2.4.1-5	1	<=200MHz	22.4	3.5	3	15.9-TT-ΔMB <sub>P,n</sub>	43
	2	<=200MHz	22.4	4.0	3	15.4-TT-ΔMB <sub>P,n</sub>	43
	3	<=200MHz	22.4	4.0	3	15.4-TT-ΔMB <sub>P,n</sub>	43
	4	<=200MHz	22.4	4.0	3	15.4-TT-ΔMB <sub>P,n</sub>	43
	5	<=200MHz	22.4	5.0	4	13.4-TT-ΔMB <sub>P,n</sub>	43
	6	<=200MHz	22.4	5.0	4	13.4-TT-ΔMB <sub>P,n</sub>	43
	7	<=200MHz	22.4	5.0	4	13.4-TT-ΔMB <sub>P,n</sub>	43
	8	<=200MHz	22.4	5.0	4	13.4-TT-ΔMB <sub>P,n</sub>	43
	9	<=200MHz	22.4	7.5	5	11.9-TT-ΔMB <sub>P,n</sub>	43
	10	<=200MHz	22.4	7.5	5	11.9-TT-ΔMB <sub>P,n</sub>	43
	11	<=200MHz	22.4	7.5	5	11.9-TT-ΔMB <sub>P,n</sub>	43
	12	<=200MHz	22.4	7.5	5	11.9-TT-ΔMB <sub>P,n</sub>	43
Table	1	400MHz	22.4	5	4	13.4-TT-ΔMB <sub>P,n</sub>	43

6.2D.2.4.1-6	2	400MHz	22.4	5	4	13.4-TT- $\Delta MB_{P,n}$	43
	3	400MHz	22.4	5	4	13.4-TT- $\Delta MB_{P,n}$	43
	4	400MHz	22.4	6.5	5	10.9-TT- $\Delta MB_{P,n}$	43
	5	400MHz	22.4	6.5	5	10.9-TT- $\Delta MB_{P,n}$	43
	6	400MHz	22.4	6.5	5	10.9-TT- $\Delta MB_{P,n}$	43
	7	400MHz	22.4	9	5	8.4-TT- $\Delta MB_{P,n}$	43
	8	400MHz	22.4	9	5	8.4-TT- $\Delta MB_{P,n}$	43
	9	400MHz	22.4	9	5	8.4-TT- $\Delta MB_{P,n}$	43
<p>Note 1: <math>\Delta MB_{P,n}</math> is the Multiband Relaxation factor declared by the UE for the tested band in table A.4.3.9-2 of TS38.508-2. This declaration shall fulfil the requirements in clause 6.2.1.1.3.3.</p> <p>Note 2: All UE supported bands needs to be tested to ensure the multiband relaxation declaration is compliant.</p> <p>Note 3: Max allowed sum of <math>\Delta MB_{P,n}</math> over all supported FR2 bands as defined in clause 6.2.1.1.3.3.</p> <p>Note 4: <math>\Delta MB_{P,n}</math> is 0 for single band UE.</p>							

Table 6.2D.2.5-5: UE Power Class test requirements for Power Class 3 (n260)

Test Configuration Table	Test ID	BW (MHz)	P <sub>Powerclass</sub>	MPR <sub>f,c</sub>	T(MPR <sub>f,c</sub> )	Lower limit (dBm)	Upper limit (dBm)
Table 6.2D.2.4.1-4	1	$\leq 200$ MHz	20.6	4.0	3	13.6-TT- $\Delta MB_{P,n}$	43
		400MHz	20.6	5.0	4	11.6-TT- $\Delta MB_{P,n}$	43
	2	$\leq 200$ MHz	20.6	4.0	3	13.6-TT- $\Delta MB_{P,n}$	43
		400MHz	20.6	5.0	4	11.6-TT- $\Delta MB_{P,n}$	43
Table 6.2D.2.4.1-5	1	$\leq 200$ MHz	20.6	3.5	3	14.1-TT- $\Delta MB_{P,n}$	43
	2	$\leq 200$ MHz	20.6	4.0	3	13.6-TT- $\Delta MB_{P,n}$	43
	3	$\leq 200$ MHz	20.6	4.0	3	13.6-TT- $\Delta MB_{P,n}$	43
	4	$\leq 200$ MHz	20.6	4.0	3	13.6-TT- $\Delta MB_{P,n}$	43
	5	$\leq 200$ MHz	20.6	5.0	4	11.6-TT- $\Delta MB_{P,n}$	43
	6	$\leq 200$ MHz	20.6	5.0	4	11.6-TT- $\Delta MB_{P,n}$	43
	7	$\leq 200$ MHz	20.6	5.0	4	11.6-TT- $\Delta MB_{P,n}$	43
	8	$\leq 200$ MHz	20.6	5.0	4	11.6-TT- $\Delta MB_{P,n}$	43
	9	$\leq 200$ MHz	20.6	7.5	5	8.1-TT- $\Delta MB_{P,n}$	43
	10	$\leq 200$ MHz	20.6	7.5	5	8.1-TT- $\Delta MB_{P,n}$	43
	11	$\leq 200$ MHz	20.6	7.5	5	8.1-TT- $\Delta MB_{P,n}$	43
	12	$\leq 200$ MHz	20.6	7.5	5	8.1-TT- $\Delta MB_{P,n}$	43
Table 6.2D.2.4.1-6	1	400MHz	20.6	5	4	11.6-TT- $\Delta MB_{P,n}$	43
	2	400MHz	20.6	5	4	11.6-TT- $\Delta MB_{P,n}$	43
	3	400MHz	20.6	5	4	11.6-TT- $\Delta MB_{P,n}$	43
	4	400MHz	20.6	6.5	5	9.1-TT- $\Delta MB_{P,n}$	43
	5	400MHz	20.6	6.5	5	9.1-TT- $\Delta MB_{P,n}$	43
	6	400MHz	20.6	6.5	5	9.1-TT- $\Delta MB_{P,n}$	43
	7	400MHz	20.6	9	5	6.6-TT- $\Delta MB_{P,n}$	43
	8	400MHz	20.6	9	5	6.6-TT- $\Delta MB_{P,n}$	43
	9	400MHz	20.6	9	5	6.6-TT- $\Delta MB_{P,n}$	43
<p>Note 1: <math>\Delta MB_{P,n}</math> is the Multiband Relaxation factor declared by the UE for the tested band in table A.4.3.9-2 of TS38.508-2. This declaration shall fulfil the requirements in clause 6.2.1.1.3.3.</p> <p>Note 2: All UE supported bands needs to be tested to ensure the multiband relaxation declaration is compliant.</p> <p>Note 3: Max allowed sum of <math>\Delta MB_{P,n}</math> over all supported FR2 bands as defined in clause 6.2.1.1.3.3.</p> <p>Note 4: <math>\Delta MB_{P,n}</math> is 0 for single band UE.</p>							



**Table 6.2D.2.5-5a: Test Tolerance (Power class 3)**

Test Metric	FR2a	FR2b
Max device size $\leq$ 30 cm	FFS	FFS

**Table 6.2D.2.5-6: UE Power Class test requirements for Power Class 4 (for Bands n257, n258, n261)**

FFS

**Table 6.2D.2.5-7: UE Power Class test requirements for Power Class 4 (for Bands n260)**

FFS

### 6.2D.3 UE maximum output power with additional requirements for UL MIMO

Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:

- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.
- OTA test procedure for UL MIMO is still under investigation

#### 6.2D.3.1 Test purpose

Additional spectrum emission requirements can be signalled by the network to indicate that the UE shall also meet additional requirements in a specific deployment scenario. To meet these additional requirements, Additional Maximum Power Reduction (A-MPR) is allowed for the output power.

#### 6.2D.3.2 Test applicability

This test case applies to all types of NR UE release 15 and forward supporting UL MIMO.

#### 6.2D.3.3 Minimum conformance requirements

##### 6.2D.3.3.1 UE maximum output power reduction with additional requirements for UL MIMO for power class 1

For UEs configured for 2-layer transmission as well as UEs configured for single layer uplink full power transmission (ULFPTx), the A-MPR values specified in clause 6.2.3.3 shall apply to the maximum output power specified in Table 6.2D.1.1.3.1-1. The requirements shall be met with the configurations specified in sub-clause 6.2D.1.0.

For the UE maximum output power modified by A-MPR, the power limits specified in clause 6.2D.4.3 apply.

##### 6.2D.3.3.2 UE maximum output power reduction with additional requirements for UL MIMO for power class 2

For UEs configured for 2-layer transmission as well as UEs configured for single layer uplink full power transmission (ULFPTx), the A-MPR values specified in clause 6.2.3.3 shall apply to the maximum output power specified in Table 6.2D.1.1.3.2-1. The requirements shall be met with the configurations specified in clause 6.2D.1.0.

For the UE maximum output power modified by A-MPR, the power limits specified in clause 6.2D.4.3 apply.

##### 6.2D.3.3.3 UE maximum output power reduction with additional requirements for UL MIMO for power class 3

For UEs configured for 2-layer transmission as well as UEs configured for single layer uplink full power transmission (ULFPTx), the A-MPR values specified in clause 6.2.3.3 shall apply to the maximum output power specified in Table 6.2D.1.1.3.3-1. The requirements shall be met with the configurations specified in clause 6.2D.1.0.

For the UE maximum output power modified by A-MPR, the power limits specified in clause 6.2D.4.3 apply.

6.2D.3.3.4 UE maximum output power reduction with additional requirements for UL MIMO for power class 4

For UEs configured for 2-layer transmission as well as UEs configured for single layer uplink full power transmission (ULFPTx), the A-MPR values specified in clause 6.2.3.3 shall apply to the maximum output power specified in Table 6.2D.1.1.3.4-1. The requirements shall be met with the configurations specified in clause 6.2D.1.0.

The normative reference for this requirement is TS 38.101-2 [3] clause 6.2D.3.

6.2D.3.4 Test description

6.2D.3.4.1 Initial conditions

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, and channel bandwidths based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each channel bandwidth and subcarrier spacing, are shown in Table 6.2D.3.4.1-1 to Table 6.2D.3.4.1-4. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.2D.3.4.1-1: Test configuration table for 2-layer UL-MIMO for NS\_202**

Initial Conditions			
Test Environment as specified in TS 38.508-1 [10] subclause 4.1		Normal	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1		Low range, High range	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1		Highest	
Test SCS as specified in Table 5.3.5-1		120kHz	
Test Parameters			
Test ID	Downlink Configuration	Uplink Configuration	
		Modulation	RB allocation (NOTE 1)
1 (NOTE 4)	-	CP-OFDM QPSK	Inner_Full
2		CP-OFDM QPSK	Inner_1RB_Left for PC2, PC3 and PC4 Inner_Partial for PC1 (NOTE 2)
3 (NOTE 3)		CP-OFDM 64QAM	Outer_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.			
NOTE 2: When testing Low range configure uplink RB to Inner_1RB_Left for PC2, PC3 and PC4 or Inner_Partial_Left_Region1 for PC1 and when testing High range configure uplink RB to Inner_1RB_Right for PC2, PC3 and PC4 or Inner_Partial_Right_Region1 for PC1.			
NOTE 3: Test ID only applicable to PC1			
NOTE 4: Test ID only applicable to PC2, PC3 and PC4			

**Table 6.2D.3.4.1-2: Test configuration table for 2-layer UL-MIMO for NS\_203**

Initial Conditions					
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1			Low range		
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1			Highest		
Test SCS as specified in Table 5.3.5-1			120kHz		
Test Parameters					
Test ID	Frequency	Channel Bandwidth	Downlink Configuration	Uplink Configuration	
			-	Modulation	RB allocation

					<b>(NOTE 1)</b>
1	Default	Default		CP-OFDM QPSK	Inner_Full
2	Default	Default		CP-OFDM QPSK	Inner_1RB_Left for PC2, PC3 and PC4 Inner_Partial for PC1 (NOTE 2)
3 (NOTE 2)	Low range + Channel Bandwidth	Default		CP-OFDM QPSK	Inner_Partial
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.					
NOTE 2: Test ID only applicable to PC1					

**Table 6.2D.3.4.1-3: Test configuration table for ULFP Tx for NS\_202**

Initial Conditions			
Test Environment as specified in TS 38.508-1 [10] subclause 4.1		Normal	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1		Low range, High range	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1		Highest	
Test SCS as specified in Table 5.3.5-1		120kHz	
Test Parameters			
Test ID	Downlink Configuration	Uplink Configuration	
		Modulation	RB allocation (NOTE 1)
1 (NOTE 4)	-	DFT-s-OFDM QPSK	Inner_Full
2		DFT-s-OFDM QPSK	Inner_1RB_Left for PC2, PC3 and PC4 Inner_Partial for PC1 (NOTE 2)
3 (NOTE 3)		DFT-s-OFDM 64QAM	Outer_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.			
NOTE 2: When testing Low range configure uplink RB to Inner_1RB_Left for PC2, PC3 and PC4 or Inner_Partial_Left_Region1 for PC1 and when testing High range configure uplink RB to Inner_1RB_Right for PC2, PC3 and PC4 or Inner_Partial_Right_Region1 for PC1.			
NOTE 3: Test ID only applicable to PC1			
NOTE 4: Test ID only applicable to PC2, PC3 and PC4			

**Table 6.2D.3.4.1-4: Test configuration table for ULFP Tx for NS\_203**

Initial Conditions					
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1			Low range		
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1			Highest		
Test SCS as specified in Table 5.3.5-1			120kHz		
Test Parameters					
Test ID	Frequency	Channel Bandwidth	Downlink Configuration	Uplink Configuration	
				Modulation	RB allocation (NOTE 1)
1	Default	Default	-	DFT-s-OFDM QPSK	Inner_Full
2	Default	Default		DFT-s-OFDM QPSK	Inner_1RB_Left for PC2, PC3 and PC4 Inner_Partial for PC1 (NOTE 2)
3 (NOTE 2)	Low range + Channel Bandwidth	Default		DFT-s-OFDM QPSK	Inner_Partial

NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.  
 NOTE 2: Test ID only applicable to PC1

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The DL and UL Reference Measurement channels are set according to Table 6.2D.3.4.1-1 to Table 6.2D.3.4.1-4.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity NR, Connected without release On, Test Mode On and Test Loop Function On according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.2D.3.4.3

#### 6.2D.3.4.2 Test procedure

1. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.2D.3.4.1-1 to Table 6.2D.3.4.1-2. Since the UL has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC.
2. Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
3. Send continuously uplink power control "up" commands in every uplink scheduling information to the UE; allow at least 200 msec starting from the first TPC command in this step to ensure that the UE transmits at its maximum output power. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
4. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
5. Measure UE EIRP in the Tx beam peak direction in the channel bandwidth of the radio access mode according to the test configuration, which shall meet the requirements described in clause 6.2D.3.5. EIRP test procedure is defined in Annex K. The measuring duration is one active uplink subframe. EIRP is calculated considering both polarizations, theta and phi.
6. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.
7. If UE supports ULFPTx, repeat test steps 1~6 with UL RMC according to Table 6.2D.3.4.1-3 and 6.2D.3.4.1-4. The PDCCH DCI format 0\_1 is specified with the condition ULFPTx\_Mode1, ULFPTx\_Mode2 or ULFPTx\_ModeFull in 38.508-1 [5] subclause 4.3.6.1.1.2 depending on UE reported capability. Message contents are according to TS 38.508-1 [5] clause 4.6.3 Table 4.6.3-118 with condition TRANSFORM\_PRECODER\_ENABLED.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

#### 6.2D.3.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 ensuring Table 4.6.3-182 with condition 2TX\_UL\_MIMO, with the following exceptions for each network signalling value.

1. Information element *AdditionalSpectrumEmission* for NR can be set in SIB1 according to TS 38.331[19]. This exception indicates that the UE shall meet the additional spurious emission requirement for a specific deployment scenario.

**Table 6.2D.3.4.3-1: *AdditionalSpectrumEmission*: Additional spurious emissions test requirement**

Derivation Path: TS 38.508-1 [10] clause 4.6.3, Table 4.6.3-1

Information Element	Value/remark	Comment	Condition
AdditionalSpectrumEmission	1 (NS_202)	for band n257	
AdditionalSpectrumEmission	2 (NS_202)	for band n258	
AdditionalSpectrumEmission	3 (NS_203)	for band n258	

6.2D.3.5 Test requirement

The UE EIRP derived in step 5 shall not exceed the values specified in Table 6.2D.3.5-1 to Table 6.2D.3.5-8. The UE EIRP derived in step 7 shall not exceed the values specified in Table 6.2D.3.5-9 to Table 6.2D.3.5-16.

**Table 6.2D.3.5-1: UE Power Class 1 test requirements for 2-layer UL-MIMO (network signalling value "NS\_202")**

Band	Test ID	P <sub>Powerclass</sub>	MPR <sub>f,c</sub>	A- MPR <sub>f,c</sub>	T(MAX(MPR <sub>f,c</sub> , A-MPR <sub>f,c</sub> ))	Lower limit (dBm)	Upper limit (dBm)
n257, n258	2	40	4.5 <sup>1</sup> 5.0 <sup>2</sup>	11	7	22-TT	55
	3		7.5 <sup>1</sup> 9.0 <sup>2</sup>	11	7	22-TT	55
NOTE 1 Applicable to BWchannel ≤ 200 MHz							
NOTE 2 Applicable to BWchannel = 400 MHz							

**Table 6.2D.3.5-2: UE Power Class 2 test requirements for 2-layer UL-MIMO (network signalling value "NS\_202")**

Band	Test ID	P <sub>Powerclass</sub>	MPR <sub>f,c</sub>	A- MPR <sub>f,c</sub>	T(MAX(MPR <sub>f,c</sub> , A-MPR <sub>f,c</sub> ))	Lower limit (dBm)	Upper limit (dBm)
n257, n258	1	29	3.5 <sup>1</sup> 5.0 <sup>2</sup>	1	3.0 <sup>1</sup> 4.0 <sup>2</sup>	22.5-TT <sup>1</sup> 20-TT <sup>2</sup>	43
	2		3.5 <sup>1</sup> 5.0 <sup>2</sup>	1	3.0 <sup>1</sup> 4.0 <sup>2</sup>	22.5-TT <sup>1</sup> 20-TT <sup>2</sup>	43
NOTE 1 Applicable to BWchannel ≤ 200 MHz							
NOTE 2 Applicable to BWchannel = 400 MHz							

**Table 6.2D.3.5-3: UE Power Class 3 test requirements for 2-layer UL-MIMO (network signalling value "NS\_202")**

Band	Test ID	P <sub>Powerclass</sub>	MPR <sub>f,c</sub>	A- MPR <sub>f,c</sub>	T(MAX(MPR <sub>f,c</sub> , A-MPR <sub>f,c</sub> ))	Lower limit (dBm)	Upper limit (dBm)
n257, n258	1	22.4	3.5 <sup>1</sup> 5.0 <sup>2</sup>	1	3.0 <sup>1</sup> 4.0 <sup>2</sup>	15.9 -TT- ΔMB <sub>P,n</sub> <sup>1</sup> 13.4 -TT- ΔMB <sub>P,n</sub> <sup>2</sup>	43
	2		3.5 <sup>1</sup> 5.0 <sup>2</sup>	1	3.0 <sup>1</sup> 4.0 <sup>2</sup>	15.9 -TT- ΔMB <sub>P,n</sub> <sup>1</sup> 13.4 -TT- ΔMB <sub>P,n</sub> <sup>2</sup>	43
NOTE 1 Applicable to BWchannel ≤ 200 MHz							
NOTE 2 Applicable to BWchannel = 400 MHz							
NOTE 3: ΔMB <sub>P,n</sub> is the Multiband Relaxation factor for the tested band. This shall fulfil the requirements in Table							

6.2.1.1.3.3-5.

**Table 6.2D.3.5-4: UE Power Class 4 test requirements for 2-layer UL-MIMO (network signalling value "NS\_202")**

Band	Test ID	P <sub>Powerclass</sub>	MPR <sub>f,c</sub>	A- MPR <sub>f,c</sub>	T(MAX(MPR <sub>f,c</sub> , A-MPR <sub>f,c</sub> ))	Lower limit (dBm)	Upper limit (dBm)
n257, n258	1	34	3.5 <sup>1</sup> 5.0 <sup>2</sup>	1	3.0 <sup>1</sup> 4.0 <sup>2</sup>	27.5 - TT <sup>1</sup> 25.0 - TT <sup>2</sup>	43
	2		3.5 <sup>1</sup> 5.0 <sup>2</sup>	1	3.0 <sup>1</sup> 4.0 <sup>2</sup>	27.5 - TT <sup>1</sup> 25.0 - TT <sup>2</sup>	43
NOTE 1 Applicable to BWchannel ≤ 200 MHz							
NOTE 2 Applicable to BWchannel = 400 MHz							

**Table 6.2D.3.5-5: UE Power Class 1 test requirements for 2-layer UL-MIMO (network signalling value "NS\_203")**

Band	Test ID	P <sub>Powerclass</sub>	MPR <sub>f,c</sub>	A- MPR <sub>f,c</sub>	T(MAX(MPR <sub>f,c</sub> , A-MPR <sub>f,c</sub> ))	Lower limit (dBm)	Upper limit (dBm)
n258	1	40	4.5 <sup>1</sup> 5.0 <sup>2</sup>	3	4	31.5 - TT <sup>1</sup> 31.0 - TT <sup>2</sup>	55
	2		4.5 <sup>1</sup> 5.0 <sup>2</sup>	3	4	31.5 - TT <sup>1</sup> 31.0 - TT <sup>2</sup>	55
	3		4.5 <sup>1</sup> 5.0 <sup>2</sup>	0	4	31.5 - TT <sup>1</sup> 31.0 - TT <sup>2</sup>	55
NOTE 1 Applicable to BWchannel ≤ 200 MHz							
NOTE 2 Applicable to BWchannel = 400 MHz							

**Table 6.2D.3.5-6: UE Power Class 2 test requirements for 2-layer UL-MIMO (network signalling value "NS\_203")**

Band	Test ID	P <sub>Powerclass</sub>	MPR <sub>f,c</sub>	A- MPR <sub>f,c</sub>	T(MAX(MPR <sub>f,c</sub> , A-MPR <sub>f,c</sub> ))	Lower limit (dBm)	Upper limit (dBm)
n258	1	29	3.5 <sup>1</sup> 5.0 <sup>2</sup>	0	3.0 <sup>1</sup> 4.0 <sup>2</sup>	22.5 - TT <sup>1</sup> 20.0 - TT <sup>2</sup>	43
	2		3.5 <sup>1</sup> 5.0 <sup>2</sup>	0	3.0 <sup>1</sup> 4.0 <sup>2</sup>	22.5 - TT <sup>1</sup> 20.0 - TT <sup>2</sup>	43
NOTE 1 Applicable to BWchannel ≤ 200 MHz							
NOTE 2 Applicable to BWchannel = 400 MHz							

**Table 6.2D.3.5-7: UE Power Class 3 test requirements for 2-layer UL-MIMO (network signalling value "NS\_203")**

Band	Test ID	P <sub>Powerclass</sub>	MPR <sub>f,c</sub>	A- MPR <sub>f,c</sub>	T(MAX(MPR <sub>f,c</sub> , A-MPR <sub>f,c</sub> ))	Lower limit (dBm)	Upper limit (dBm)
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n258	1	22.4	3.5 <sup>1</sup> 5.0 <sup>2</sup>	0	3.0 <sup>1</sup> 4.0 <sup>2</sup>	15.9-TT- $\Delta MB_{P,n}^1$ 13.4-TT- $\Delta MB_{P,n}^2$	43
	2		3.5 <sup>1</sup> 5.0 <sup>2</sup>	0	3.0 <sup>1</sup> 4.0 <sup>2</sup>	15.9-TT- $\Delta MB_{P,n}^1$ 13.4-TT- $\Delta MB_{P,n}^2$	43
NOTE 1 Applicable to BWchannel ≤ 200 MHz							
NOTE 2 Applicable to BWchannel = 400 MHz							
NOTE 3: $\Delta MB_{P,n}$ is the Multiband Relaxation factor for the tested band. This shall fulfil the requirements in Table 6.2.1.1.3.3-5.							

**Table 6.2D.3.5-8: UE Power Class 4 test requirements for 2-layer UL-MIMO (network signalling value "NS\_203")**

Band	Test ID	P <sub>Powerclass</sub>	MPR <sub>f,c</sub>	A- MPR <sub>f,c</sub>	T(MAX(MPR <sub>f,c</sub> , A- MPR <sub>f,c</sub> ))	Lower limit (dBm)	Upper limit (dBm)
n258	1	34	3.5 <sup>1</sup> 5.0 <sup>2</sup>	0	3.0 <sup>1</sup> 4.0 <sup>2</sup>	27.5-TT <sup>1</sup> 25-TT <sup>2</sup>	43
	2		3.5 <sup>1</sup> 5.0 <sup>2</sup>	0	3.0 <sup>1</sup> 4.0 <sup>2</sup>	27.5-TT <sup>1</sup> 25-TT <sup>2</sup>	43
NOTE 1 Applicable to BWchannel ≤ 200 MHz							
NOTE 2 Applicable to BWchannel = 400 MHz							

**Table 6.2D.3.5-9: UE Power Class 1 test requirements for ULFPTx (network signalling value "NS\_202")**

Band	Test ID	P <sub>Powerclass</sub>	MPR <sub>f,c</sub>	A- MPR <sub>f,c</sub>	T(MAX(MPR <sub>f,c</sub> , A- MPR <sub>f,c</sub> ))	Lower limit (dBm)	Upper limit (dBm)
n257, n258	2	40	0	11	7	22-TT	55
	3		6.5	11	7	22-TT	55

**Table 6.2D.3.5-10: UE Power Class 2 test requirements for ULFPTx (network signalling value "NS\_202")**

Band	Test ID	P <sub>Powerclass</sub>	MPR <sub>f,c</sub>	A- MPR <sub>f,c</sub>	T(MAX(MPR <sub>f,c</sub> , A- MPR <sub>f,c</sub> ))	Lower limit (dBm)	Upper limit (dBm)
n257, n258	1	29	0	1	1.5	26.5-TT	43
	2		0	1	1.5	26.5-TT	43

**Table 6.2D.3.5-11 UE Power Class 3 test requirements for ULFP Tx (network signalling value "NS\_202")**

Band	Test ID	P <sub>Powerclass</sub>	MPR <sub>f,c</sub>	A- MPR <sub>f,c</sub>	T(MAX(MPR <sub>f,c</sub> , A-MPR <sub>f,c</sub> ))	Lower limit (dBm)	Upper limit (dBm)
n257, n258	1	22.4	0	1	1.5	19.2-TT- $\Delta$ MB <sub>P,n</sub>	43
	2		0	1	1.5	19.2-TT- $\Delta$ MB <sub>P,n</sub>	43
Note 1: $\Delta$ MB <sub>P,n</sub> is the Multiband Relaxation factor for the tested band. This shall fulfil the requirements in Table 6.2.1.1.3.3-5.							

**Table 6.2D.3.5-12: UE Power Class 4 test requirements for ULFP Tx (network signalling value "NS\_202")**

Band	Test ID	P <sub>Powerclass</sub>	MPR <sub>f,c</sub>	A- MPR <sub>f,c</sub>	T(MAX(MPR <sub>f,c</sub> , A-MPR <sub>f,c</sub> ))	Lower limit (dBm)	Upper limit (dBm)
n257, n258	1	34	0	1	1.5	31.5-TT	43
	2		0	1	1.5	31.5-TT	43

**Table 6.2D.3.5-13: UE Power Class 1 test requirements for ULFP Tx (network signalling value "NS\_203")**

Band	Test ID	P <sub>Powerclass</sub>	MPR <sub>f,c</sub>	A- MPR <sub>f,c</sub>	T(MAX(MPR <sub>f,c</sub> , A-MPR <sub>f,c</sub> ))	Lower limit (dBm)	Upper limit (dBm)
n258	1	40	0	3	2	35-TT	55
	2		0	3	2	35-TT	55
	3		0	0	0	40-TT	55

**Table 6.2D.3.5-14: UE Power Class 2 test requirements for ULFP Tx (network signalling value "NS\_203")**

Band	Test ID	P <sub>Powerclass</sub>	MPR <sub>f,c</sub>	A- MPR <sub>f,c</sub>	T(MAX(MPR <sub>f,c</sub> , A-MPR <sub>f,c</sub> ))	Lower limit (dBm)	Upper limit (dBm)
n258	1	29	0	0	0	29-TT	43
	2		0	0	0	29-TT	43



**Table 6.2D.3.5-15: UE Power Class 3 test requirements for ULFPTx (network signalling value "NS\_203")**

Band	Test ID	P <sub>Powerclass</sub>	MPR <sub>f,c</sub>	A- MPR <sub>f,c</sub>	T(MAX(MPR <sub>f,c</sub> , A-MPR <sub>f,c</sub> ))	Lower limit (dBm)	Upper limit (dBm)
n258	1	22.4	0	0	0	22.4-TT- $\Delta$ MB <sub>P,n</sub>	43
	2		0	0	0	22.4-TT- $\Delta$ MB <sub>P,n</sub>	43
Note 1: $\Delta$ MB <sub>P,n</sub> is the Multiband Relaxation factor for the tested band. This shall fulfil the requirements in Table 6.2.1.1.3.3-5.							

**Table 6.2D.3.5-16: UE Power Class 4 test requirements for ULFPTx (network signalling value "NS\_203")**

Band	Test ID	P <sub>Powerclass</sub>	MPR <sub>f,c</sub>	A- MPR <sub>f,c</sub>	T(MAX(MPR <sub>f,c</sub> , A-MPR <sub>f,c</sub> ))	Lower limit (dBm)	Upper limit (dBm)
n258	1	34	0	0	0	34-TT	43
	2		0	0	0	34-TT	43

**Table 6.2D.3.5-17: Test Tolerance (Power class 3)**

Test Metric	FR2a	FR2b
Max device size $\leq$ 30 cm	3.11 dB	3.11 dB

## 6.2D.4 Configured transmitted power for UL MIMO

### 6.2D.4.1 Test purpose

To verify the UE transmitted power  $P_{UMAX,f,c}$  is within the range defined prescribed by the specified nominal maximum output power and tolerance.

### 6.2D.4.2 Test applicability

The requirements of this test are covered in test cases 6.2D.1 UE Maximum output power for UL MIMO, 6.2D.2 UE maximum output power reduction for UL MIMO and 6.2D.3 UE Maximum output power with additional requirements for UL MIMO to all types of NR UE release 15 and forward that supports UL MIMO.

### 6.2D.4.3 Minimum conformance requirements

For UEs configured for 2-layer transmission as well as UEs configured for single layer uplink full power transmission (ULFPTx), the configured maximum output power  $P_{CMAX,c}$  for serving cell c is defined as sum of all streams and is bound by limits set in section 6.2.4.

The normative reference for this requirement is TS 38.101-2 [3] clause 6.2D.4.

### 6.2D.4.4 Test description

This test is covered by clause 6.2D.1 UE Maximum output power for UL MIMO, 6.2D.2 UE maximum output power reduction for UL MIMO and 6.2D.3 UE Maximum output power with additional requirements for UL MIMO.

### 6.2D.4.5 Test requirements

This test is covered by clause 6.2D.1 UE Maximum output power for UL MIMO, 6.2D.2 UE maximum output power reduction for UL MIMO and 6.2D.3 UE Maximum output power with additional requirements for UL MIMO.

## 6.3 Output power dynamics

### 6.3.1 Minimum output power

**Editor's Note: The following aspects of the clause are for future consideration:**

- **Relaxation, Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.**

#### 6.3.1.1 Test purpose

To verify the UE's ability to transmit with a broadband output power below the value specified in the test requirement when the power is set to a minimum value.

#### 6.3.1.2 Test applicability

This test case applies to all types of NR UE release 15 and forward.

#### 6.3.1.3 Minimum conformance requirements

The minimum controlled output power of the UE is defined as the EIRP in the channel bandwidth for all transmit bandwidth configurations (resource blocks) when the power is set to a minimum value.

The minimum output power is defined as the mean power in at least one subframe (1ms).

##### 6.3.1.3.1 Minimum output power for power class 1

For power class 1 UE, the minimum output power shall not exceed the values specified in Table 6.3.1.3.1-1 for each operating band supported. The minimum power is verified in beam locked mode with the test metric of EIRP (Link=TX beam peak direction, Meas=Link angle).

**Table 6.3.1.3.1-1: Minimum output power for power class 1**

Operating band	Channel bandwidth (MHz)	Minimum output power (dBm)	Measurement bandwidth (MHz)
n257, n258, n260, n261	50	4	47.58
	100	4	95.16
	200	4	190.20
	400	4	380.28

##### 6.3.1.3.2 Minimum output power for power class 2, 3, and 4

The minimum output power shall not exceed the values specified in Table 6.3.1.3.2-1 for each operating band supported. The minimum power is verified in beam locked mode with the test metric of EIRP (Link=TX beam peak direction, Meas=Link angle).

**Table 6.3.1.3.2-1: Minimum output power for power class 2, 3, and 4**

Operating band	Channel bandwidth (MHz)	Minimum output power (dBm)	Measurement bandwidth (MHz)
n257, n258, n260, n261	50	-13	47.58
	100	-13	95.16
	200	-13	190.20
	400	-13	380.28

NOTE 1: n260 is not applied for power class 2.

The normative reference for this requirement is TS 38.101-2 [3] clause 6.3.1.

### 6.3.1.3.3 Minimum output power for power 6

The minimum output power shall not exceed the values specified in Table 6.3.1.3.3-1 for each operating band supported. The minimum power is verified in beam locked mode with the test metric of EIRP (Link=TX beam peak direction, Meas=Link angle).

**Table 6.3.1.3.3-1: Minimum output power for power 6**

Operating band	Channel bandwidth (MHz)	Minimum output power (dBm)	Measurement bandwidth (MHz)
n257, n258, n259, n261	50	-6	47.52
	100	-6	95.04
	200	-6	190.08
	400	-6	380.16

### 6.3.1.4 Test description

#### 6.3.1.4.1 Initial condition

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, test channel bandwidths and sub-carrier spacing based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each combination of test channel bandwidth and sub-carrier spacing, and are shown in Table 6.3.1.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annex A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.3.1.4.1-1: Test Configuration Table**

Initial Conditions			
Test Environment as specified in TS 38.508-1 [10] subclause 4.1		Normal, TL, TH	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1		Low range, Mid range, High range	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1		Lowest, Mid, Highest	
Test SCS as specified in Table 5.3.5-1.		Highest	
Test Parameters			
Test ID	Downlink Configuration		Uplink Configuration
	-		Modulation
1			RB allocation (NOTE 1)
			DFT-s-OFDM QPSK
			Outer_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.			

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] clause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement Channel is set according to Table 6.3.1.4.1-1.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in State RRC\_CONNECTED with generic procedure parameters Connectivity NR, Connected without release On, Test Mode On and Test Loop Function On according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.3.1.4.3.

## 6.3.1.4.2 Test procedure

1. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.3.1.4.1-1. Since the UE has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC.
2. Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
3. Send continuously uplink power control "down" commands in every uplink scheduling information to the UE; allow at least 200ms starting from the first TPC command in this step to ensure that the UE transmits at its minimum output power. If UE is disconnected, repeat the test case. Optionally, send continuously uplink power control "down" commands in every uplink scheduling information to the UE until the UE EIRP measured by the test system is at a level just before the UE was disconnected. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
4. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
5. Measure UE EIRP in the Tx beam peak direction in the measurement bandwidth specified in Table 6.3.1.5-1 and Table 6.3.1.5-2 for the specific channel bandwidth under test. EIRP test procedure is defined in Annex K.1.3. The measuring duration is at least one active subframe (1ms). EIRP is calculated considering both polarizations, theta and phi. For TDD, only slots consisting of only UL symbols are under test.
6. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

## 6.3.1.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with TRANSFORM\_PRECODER\_ENABLED condition in Table 4.6.3-118 PUSCH-Config.

## 6.3.1.5 Test requirement

The maximum EIRP, derived in step 5 shall not exceed the values specified in Table 6.3.1.5-1 and Table 6.3.1.5-2.

**Table 6.3.1.5-1: Minimum output power for power class 1**

Operating band	Channel bandwidth (MHz)	Minimum output power (dBm)	Measurement bandwidth (MHz)
n257, n258, n260, n261	50	4+TBD+TT	47.58
	100	4+TBD+TT	95.16
	200	4+TBD+TT	190.20
	400	4+TBD+TT	380.28

**Table 6.3.1.5-2: Minimum output power for power class 3**

Operating band	Channel bandwidth (MHz)	Minimum output power (dBm)	Test Tolerance TT (dB)	Measurement bandwidth (MHz)
n257, n258, n261	50	-13+TT	4.21	47.58
	100	-13+2.4+TT <sup>1</sup>	2.52	95.16
	200	-13+5.4+TT <sup>1</sup>	0.66	190.20
	400	-13+8.4+TT <sup>1</sup>	0	380.28
n260	50	-13+4.5+TT <sup>1</sup>	1.17	47.58
	100	-13+7.5+TT <sup>1</sup>	0	95.16
	200	-13+10.5+TT <sup>1</sup>	0	190.20
	400	-13+13.5+TT <sup>1</sup>	0	380.28

NOTE 1: Core requirement cannot be tested due to testability issue and test requirement includes relaxation to achieve impact from test system noise to measurement result = 1.0 dB (Minimum requirement + relaxation).

**Table 6.3.1.5-2a: Minimum output power for power class 2 and 4**

Operating band	Channel bandwidth (MHz)	Minimum output power (dBm)	Measurement bandwidth (MHz)
n257, n258, n260, n261	50	-13+TBD+TT	47.58
	100	-13+TBD+TT	95.16
	200	-13+TBD+TT	190.20
	400	-13+TBD+TT	380.28
NOTE 1: n260 is not applied for power class 2.			

**Table 6.3.1.5-3: Minimum output power Test tolerance for power class 1, 2, 4**

FFS

**Table 6.3.1.5-4: Void**

## 6.3.2 Transmit OFF power

Editor's note: Following aspects are either missing or not yet determined otherwise:

- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.
- Measurement grid for PC2/4 in Annex M.4 is TBD.
- The testability of this test case is pending further analysis on relaxation of the requirement for other than Band n257.

### 6.3.2.1 Test purpose

To verify that the UE transmit OFF power is lower than the value specified in the test requirement.

An excess transmit OFF power potentially increases the Rise Over Thermal (RoT) and therefore reduces the cell coverage area for other UEs.

### 6.3.2.2 Test applicability

This test applies to all types of NR UE release 15 and forward.

NOTE: Currently, this test case can only support Band n257 and PC3.

### 6.3.2.3 Minimum conformance requirements

The transmit OFF power is defined as the TRP in the channel bandwidth when the transmitter is OFF. The transmitter is considered OFF when the UE is not allowed to transmit on any of its ports.

The transmit OFF power shall not exceed the values specified in Table 6.3.2.3-1 for each operating band supported. The requirement is verified with the test metric of TRP (Link=TX beam peak direction, Meas=TRP grid).

**Table 6.3.2.3-1: Transmit OFF power**

Operating band	Channel bandwidth / Transmit OFF power (dBm) / measurement bandwidth			
	50 MHz	100 MHz	200 MHz	400 MHz
n257, n258, n259, n260, n261	-35	-35	-35	-35
	47.58 MHz	95.16 MHz	190.20 MHz	380.28 MHz

The normative reference for this requirement is TS 38.101-2 [3] clause 6.3.2.

### 6.3.2.4 Test description

#### 6.3.2.4.1 Initial condition

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, test channel bandwidths and sub-carrier spacing based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each combination of test channel bandwidth and sub-carrier spacing, and are shown in Table 6.3.2.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.3.2.4.1-1: Test Configuration Table**

Initial Conditions				
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1			Low range, Mid range, High range	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1			Lowest	
Test SCS as specified in Table 5.3.5-1.			Highest	
Test Parameters				
Test ID	Downlink Configuration		Uplink Configuration	
	Modulation	RB allocation	Modulation	RB allocation
1	-	-	-	-

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement Channels are set according to Table 6.3.2.4.1-1.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in State RRC\_CONNECTED with generic procedure parameters Connectivity NR, Connected without release On, Test Mode On and Test Loop Function On according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.3.2.4.3.

#### 6.3.2.4.2 Test procedure

1. Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE) for the UE Tx beam selection to complete.
2. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
3. Measure UE TRP for the assigned NR channel with a rectangular measurement filter with bandwidths according to Table 6.3.2.5-1. Total radiated power is measured according to TRP measurement procedure defined in Annex K. TRP is calculated considering both polarizations, theta and phi.

NOTE: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

#### 6.3.2.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6.

### 6.3.2.5 Test requirement

The requirement for the transmit OFF power shall not exceed the values specified in Table 6.3.2.5-1.

**Table 6.3.2.5-1: Transmit OFF power**

Operating band	Channel bandwidth / Transmit OFF power (dBm) / measurement bandwidth			
	50 MHz	100 MHz	200 MHz	400 MHz
n257 <sup>2</sup>	-35+21.4	-35+24.4	-35+27.4	-35+30.4
	47.58 MHz	95.16 MHz	190.20 MHz	380.28 MHz
n258, n261	-35+[21.4]	-35+[24.4]	-35+[27.4]	-35+[30.4]
	47.58 MHz	95.16 MHz	190.20 MHz	380.28 MHz
n260	-35+[24.1]	-35+[27.1]	-35+[30.1]	-35+[33.1]
	47.58 MHz	95.16 MHz	190.20 MHz	380.28 MHz
NOTE 1: Core requirement cannot be tested due to testability issue and test requirement includes relaxation to achieve impact from test system noise to measurement result = 1.0 dB (Minimum requirement + relaxation).				
NOTE 2: Relaxed n257 test requirement is testable for PC3 and PC1.				

## 6.3.3 Transmit ON/OFF time mask

### 6.3.3.1 General

The transmit ON/OFF time mask defines the transient period(s) allowed

- between transmit OFF power and transmit ON power symbols (transmit ON/OFF)
- between continuous ON-power transmissions when power change or RB hopping is applied.

In case of RB hopping, transition period is shared symmetrically.

Unless otherwise stated the minimum requirements in clause 6.5 apply also in transient periods.

The transmit ON/OFF time mask is defined as a directional requirement. The requirement is verified in beam locked mode at beam peak direction. The maximum allowed EIRP OFF power level is -30dBm at beam peak direction. The requirement is verified with the test metric of EIRP (Link=TX beam peak direction, Meas=Link angle).

In the following sub-clauses, following definitions apply:

- A slot transmission is a Type A transmission.
- A long subslot transmission is a Type B transmission with more than 2 symbols.
- A short subslot transmission is a Type B transmission with 1 or 2 symbols.

### 6.3.3.2 General ON/OFF time mask

**Editor's Note: The following aspects are either missing or not yet determined:**

- **Measurement Uncertainty and Test Tolerances are FFS for power class 1, 2 and 4.**
- **Measurement Uncertainty and Test Tolerances are FFS for band n259.**

#### 6.3.3.2.1 Test purpose

To verify that the general ON/OFF time mask meets the requirements given in 6.3.3.2.5.

The transmit ON/OFF time mask defines the transient period(s) allowed

- between transmit OFF power and transmit ON power symbols (transmit ON/OFF)

Unless otherwise stated the minimum requirements in clause 6.5 apply also in transient periods.

Transmission of the wrong power increases interference to other channels, or increases transmission errors in the uplink channel.

6.3.3.2.2 Test applicability

This test case applies to all types of NR UE release 15 and forward.

6.3.3.2.3 Minimum conformance requirements

The transmit ON/OFF time mask is defined as a directional requirement. The requirement is verified in beam locked mode at beam peak direction. The maximum allowed EIRP OFF power level is -30dBm at beam peak direction. The requirement is verified with the test metric of EIRP (Link=TX beam peak direction, Meas=Link angle)

The general ON/OFF time mask defines the observation period allowed between transmit OFF and ON power. ON/OFF scenarios include: contiguous, and non-contiguous transmission, etc.

The OFF power measurement period is defined in a duration of at least one slot excluding any transient periods. The ON power is defined as the mean power over one slot excluding any transient period.

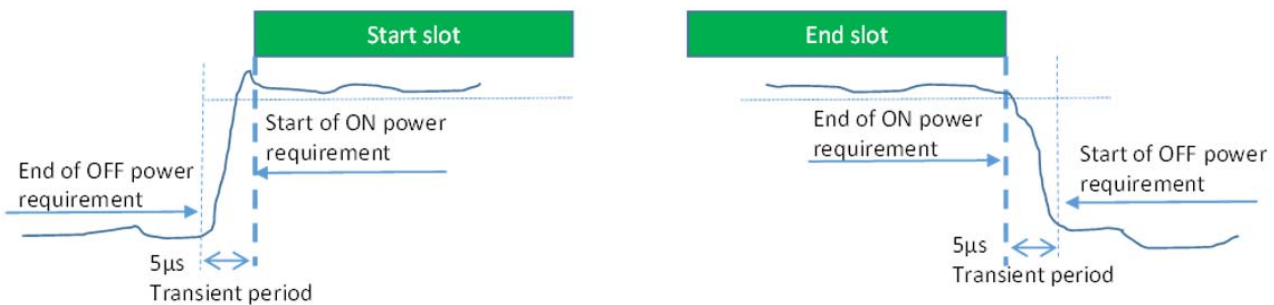


Figure 6.3.3.2.3-1: General ON/OFF time mask for NR UL transmission in FR2

The normative reference for this requirement is TS 38.101-2 [3] clause 6.3.3.2.

6.3.3.2.4 Test description

6.3.3.2.4.1 Initial condition

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, test channel bandwidths and sub-carrier spacing based on NR operating bands specified in Table 5.2-1. All of these configurations shall be tested with applicable test parameters for each combination of test channel bandwidth and sub-carrier spacing, and are shown in Table 6.3.3.2.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

Table 6.3.3.2.4.1-1: Test Configuration Table

Initial Conditions			
Test Environment as specified in TS 38.508-1 [10] subclause 4.1		Normal, TL, TH	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1		Low range, Mid range, High range	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1		Lowest, Mid, Highest	
Test SCS as specified in Table 5.3.5-1.		Highest	
Test Parameters			
Test ID	Downlink Configuration		Uplink Configuration
	-		Modulation RB allocation (NOTE 1)



1	DFT-s-OFDM QPSK	Inner_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.		

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement Channels are set according to Table 6.3.3.2.4.1-1.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in State RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.3.3.2.4.3.

#### 6.3.3.2.4.2 Test procedure

1. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.3.3.2.4.1-1. Since the UE has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC. The UL assignment is such that the UE transmits on slot 37 for 60kHz SCS and on slot 74 for 120kHz SCS.
2. Set the UE in the Inband Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
3. Send continuously uplink power control "up" commands in every uplink scheduling information to the UE; allow at least 200 msec starting from the first TPC command in this step to ensure that the UE transmits at its maximum output power. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
4. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
5. ON power sub test:
  - 5.1. For UE transmission ON power, measure UE EIRP in the Tx beam peak direction in the channel bandwidth of the radio access mode according to the test configuration, which shall meet the requirements described in Table 6.3.3.2.5-2. EIRP test procedure is defined in Annex K. The period of the measurement shall be one slot with PUSCH transmission. EIRP is calculated considering both polarizations, theta and phi. For TDD, only slots consisting of only UL symbols are under test.
6. OFF power sub test:
  - 6.1. For UE transmission OFF power, measure UE EIRP in the Tx beam peak direction in the channel bandwidth of the radio access mode according to the test configuration, which shall meet the requirements described in Table 6.3.3.2.5-1. EIRP test procedure is defined in Annex K.1.3. The period of the measurement shall be the slot prior to the PUSCH transmission, excluding a transient period of 5  $\mu$ s in the end of the slot and any DL periods. EIRP is calculated considering both polarizations, theta and phi.
  - 6.2. For UE transmission OFF power, measure UE EIRP in the Tx beam peak direction in the channel bandwidth of the radio access mode according to the test configuration, which shall meet the requirements described in Table 6.3.3.2.5-1. EIRP test procedure is defined in Annex K.1.3. The period of the measurement shall be the slot following the PUSCH transmission, excluding a transient period of 5  $\mu$ s at the beginning of the slot and any DL periods. EIRP is calculated considering both polarizations, theta and phi.
7. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

## 6.3.3.2.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with TRANSFORM\_PRECODER\_ENABLED condition in Table 4.6.3-118 PUSCH-Config.

**Table 6.3.3.2.4.3-1: Void**

**Table 6.3.3.2.4.3-2: Void**

**Table 6.3.3.2.4.3-3: Void**

## 6.3.3.2.5 Test requirement

The requirement for the EIRP measured in steps 5 and 6 of the test procedure shall not exceed the values specified in Table 6.3.3.2.5-1 and 6.3.3.2.5-2.

**Table 6.3.3.2.5-1: Test requirement of OFF power of General ON/OFF time mask**

	Channel bandwidth / minimum output power / measurement bandwidth			
	50 MHz	100 MHz	200 MHz	400 MHz
Transmit OFF power	$\leq -30+TT+R$ dBm			
Transmission OFF Measurement bandwidth	47.58 MHz	95.16 MHz	190.20 MHz	380.28 MHz
NOTE 1: Core requirement cannot be tested due to testability issue and test requirement includes relaxation to achieve impact from test system noise to measurement result = 1.0 dB (Minimum requirement + relaxation R).				
NOTE 2: Relaxation R is specified in Table 6.3.3.2.5-5.				
NOTE 3: TT = 0 dB.				

**Table 6.3.3.2.5-2: Test requirement of ON power of General ON/OFF time mask**

	Channel bandwidth / measurement bandwidth			
	50 MHz	100 MHz	200 MHz	400 MHz
Transmit ON power	Same as the EIRP requirements described in 6.2.1.1.5			
NOTE 1: Void.				

**Table 6.3.3.2.5-3: Void**

**Table 6.3.3.2.5-4: Void**

**Table 6.3.3.2.5-5: Relaxation required for OFF power for PC1 and PC3 UEs**

Operating band	50 MHz	100 MHz	200 MHz	400 MHz
n257, n258, n261	EIRP - 1 dB	EIRP + 2 dB	EIRP + 5 dB	EIRP + 8 dB
n260	EIRP + 2 dB	EIRP + 5 dB	EIRP + 8 dB	EIRP + 11 dB
NOTE 1: EIRP is measured value in the ON power sub test, and the unit is dBm.				

## 6.3.3.3 Transmit power time mask for slot and short or long subslot boundaries

No test case details are specified. Current test procedures for time masks are based on power measurement in relatively long period compared with transient period. For time masks between 2 active time slots with different power level, the test procedure can't provide enough resolution to identify non-conformant UEs. Therefore the minimum requirement is not testable.

### 6.3.3.4 PRACH time mask

Editor's Notes: This clause is incomplete. The following aspects are either missing or not yet determined:

- Message contents are not complete
- Measurement uncertainty and Test tolerance are not complete
- Test requirements are not complete
- PRACH configuration index is not complete
- The further investigation is essential that how does beamforming affect the initial access procedure
- TP analysis is FFS.

#### 6.3.3.4.1 Test purpose

To verify that the PRACH time mask meets the requirements given in 6.3.3.4.5.

The time mask for PRACH time mask defines the transient period(s) allowed between transmit OFF power and transmit ON power when transmitting the PRACH.

Transmission of the wrong power increases interference to other channels, or increases transmission errors in the uplink channel.

#### 6.3.3.4.2 Test applicability

This test case applies to all types of NR UE release 15 and forward.

#### 6.3.3.4.3 Minimum conformance requirements

The transmit ON/OFF time mask is defined as a directional requirement. The requirement is verified in beam locked mode at beam peak direction. The maximum allowed EIRP OFF power level is -30dBm at beam peak direction. The requirement is verified with the test metric of EIRP (Link=TX beam peak direction, Meas=Link angle).

The PRACH ON power is specified as the mean power over the PRACH measurement period excluding any transient periods as shown in Figure 6.3.3.4.3-1. The measurement period for different PRACH preamble format is specified in Table 6.3.3.4.3-1.

**Table 6.3.3.4.3-1: PRACH ON power measurement period**

Format	SCS	Measurement period
A <sub>1</sub>	60 kHz	0.035677 ms
	120 kHz	0.017839 ms
A <sub>2</sub>	60 kHz	0.071354 ms
	120 kHz	0.035677 ms
A <sub>3</sub>	60 kHz	0.107031 ms
	120 kHz	0.053516 ms
B <sub>1</sub>	60 kHz	0.035091 ms
	120 kHz	0.0175455 ms
B <sub>4</sub>	60 kHz	0.207617 ms
	120 kHz	0.103809 ms
A <sub>1</sub> /B <sub>1</sub>	60 kHz	0.035677 ms for front X1 occasion 0.035091 ms for last occasion X1 = [2,5]
	120 kHz	0.017839 ms for front X1 occasion 0.017546 ms for last occasion X1 = [2,5]
A <sub>2</sub> /B <sub>2</sub>	60 kHz	0.071354 ms for front X2 occasion 0.069596 ms for last occasion X2 = [1,2]
	120 kHz	0.035677 ms for front X2 occasion 0.034798 ms for last occasion X2 = [1,2]

A <sub>3</sub> /B <sub>3</sub>	60 kHz	0.107031 ms for first occasion 0.104101 ms for second occasion
	120 kHz	0.053515 ms for first occasion 0.052050 ms for second occasion
C <sub>0</sub>	60 kHz	0.026758 ms
	120 kHz	0.013379 ms
C <sub>2</sub>	60 kHz	0.083333 ms
	120 kHz	0.0416667 ms
NOTE: For PRACH on PRACH occasion start from begin of 0ms or 0.5ms boundary, the measurement period will plus 0.032552μs		

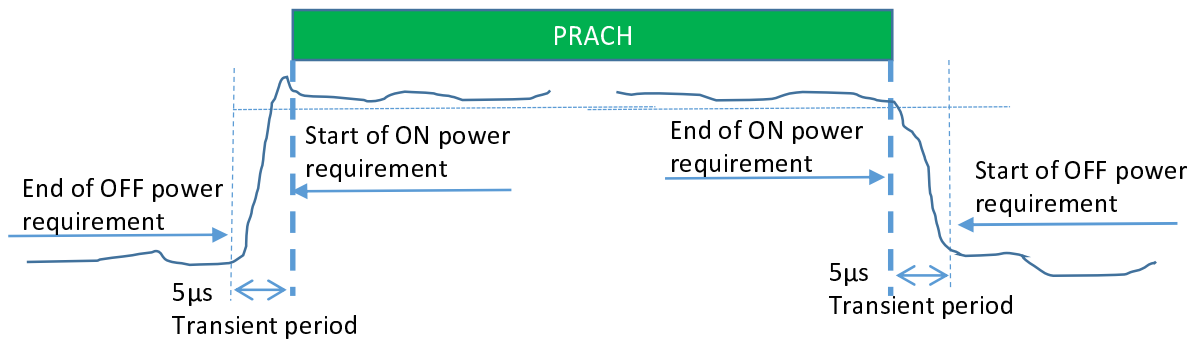


Figure 6.3.3.4.3-1: PRACH ON/OFF time mask

The normative reference for this requirement is TS 38.101-2 [3] clause 6.3.3.4.

6.3.3.4.4 Test description

6.3.3.4.4.1 Initial condition

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, test channel bandwidths and sub-carrier spacing based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each combination of test channel bandwidth and sub-carrier spacing, and are shown in Table 6.3.3.4.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

Table 6.3.3.4.4.1-1: Test Configuration Table

Initial Conditions	
Test Environment as specified in TS 38.508-1 [10] subclause 4.1	Normal, TL, TH
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1	Mid range
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1	Lowest, Mid, Highest
Test SCS as specified in Table 5.3.5-1	SCS defined in TS 38.211 [8] subclause 6.3.3.2
PRACH preamble format	
PRACH Configuration Index	[0]

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.

4. Propagation conditions are set according to Annex B.0.
5. Ensure the UE is in State RRC\_CONNECTED with generic procedure parameters Connectivity NR, Connected without release On, Test Mode On and Test Loop Function On according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.3.3.4.4.3.

#### 6.3.3.4.4.2 Test procedure

1. Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
2. The SS shall signal a Random Access Preamble ID via a PDCCH order to the UE and initiate a Non-contention based Random Access procedure.
3. The UE shall send the signalled preamble to the SS.
4. For UE transmission OFF power, measure UE EIRP in the Tx beam peak direction in the channel bandwidth of the radio access mode according to the test configuration, which shall meet the requirements described in Table 6.3.3.4.5-1. EIRP test procedure is defined in Annex K.1.3. The period of the measurement shall be the slot prior to the PRACH transmission, excluding a transient period of 5  $\mu$ s in the end of the slot and any DL periods. EIRP is calculated considering both polarizations, theta and phi.
5. For UE transmission ON power, measure UE EIRP in the Tx beam peak direction in the channel bandwidth of the radio access mode according to the test configuration, which shall meet the requirements described in Table 6.3.3.4.5-1. EIRP test procedure is defined in Annex K.1.3. The period of the measurement shall be the slot during the PRACH preamble transmission. EIRP is calculated considering both polarizations, theta and phi. For TDD, only slots consisting of only UL symbols are under test.
6. For UE transmission OFF power, measure UE EIRP in the Tx beam peak direction in the channel bandwidth of the radio access mode according to the test configuration, which shall meet the requirements described in Table 6.3.3.2.5-1. EIRP test procedure is defined in Annex K.1.3. The period of the measurement shall be the slot following the PUSCH transmission, excluding a transient period of 5  $\mu$ s at the beginning of the slot and any DL periods. EIRP is calculated considering both polarizations, theta and phi.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

#### 6.3.3.4.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with following exceptions:

**Table 6.3.3.4.4.3-1: RACH-ConfigCommon: PRACH measurement**

Derivation Path: TS 38.508-1[5], Table 4.6.3-128			
Information Element	Value/remark	Comment	Condition
RACH-ConfigCommon ::= SEQUENCE {			
rach-ConfigGeneric	RACH-ConfigGeneric		
totalNumberOfRA-Preambles	Not present		
ssb-perRACH-OccasionAndCB-PreamblesPerSSB CHOICE {			
one	n4		FR2
}			
groupBconfigured	Not present		
ra-ContentionResolutionTimer	sf64		
rsrp-ThresholdSSB	RSRP-Range		
rsrp-ThresholdSSB-SUL	Not present		
	RSRP-Range		SUL
prach-RootSequenceIndex CHOICE {			
l139	Set according to table 4.4.2-2 for the NR Cell.		PRACH Format A3
}			
msg1-SubcarrierSpacing	SubcarrierSpacing		
restrictedSetConfig	unrestrictedSet		
msg3-transformPrecoder	Not present	transform precoding is disabled for Msg3	

		PUSCH transmission and any PUSCH transmission scheduled with DCI format 0_0	
}			

**Table 6.3.3.4.4.3-2: RACH-ConfigGeneric: PRACH measurement**

Derivation Path: TS 38.508-1[5], Table 4.6.3-130			
Information Element	Value/remark	Comment	Condition
RACH-ConfigGeneric ::= SEQUENCE {			
prach-ConfigurationIndex	[TBD]	Unpaired Spectrum	PRACH Format A3
msg1-FDM	one		FR2
msg1-FrequencyStart	0		
zeroCorrelationZoneConfig	15		
preambleReceivedTargetPower	[TBD]		PRACH Format A3
preambleTransMax	n7		
powerRampingStep	dB0		
ra-ResponseWindow	sl20		
}			

**Table 6.3.3.4.4.3-3: ServingCellConfigCommonSIB: PRACH measurement**

Derivation Path: TS 38.508-1[5], Table 4.6.3-169			
Information Element	Value/remark	Comment	Condition
ServingCellConfigCommonSIB ::= SEQUENCE {			
ssb-PositionsInBurst SEQUENCE {			
inOneGroup	'1000 0000'B		
groupPresence	Not present		
}			
ss-PBCH-BlockPower	[TBD]		
}			

6.3.3.4.5 Test requirement

The requirement for the power measured in steps 4, 5 and 6 of the test procedure shall not exceed the values specified in Table 6.3.3.4.5-1.

**Table 6.3.3.4.5-1: PRACH time mask**

	Channel bandwidth / Output Power [dBm] / measurement bandwidth			
	50MHz	100MHz	200MHz	400MHz
Transmit OFF power	≤ -30+TT + R			
Transmission OFF Measurement bandwidth	47.58 MHz	95.16 MHz	190.20 MHz	380.28 MHz
Expected PRACH Transmission ON Measured power	FFS	FFS	FFS	FFS
ON power tolerance FFS	FFS	FFS	FFS	FFS
NOTE 1: Core requirement cannot be tested due to testability issue and test requirement includes relaxation to achieve impact from test system noise to measurement result = 1.0 dB (Minimum requirement + relaxation R).				
NOTE 2: Relaxation R is specified in Table 6.3.3.4.5-2.				

**Table 6.3.3.4.5-2: Relaxations for OFF power for PC3 UEs**

Operating band	50 MHz	100 MHz	200 MHz	400 MHz
n257, n258, n261	19.4 dB	22.4 dB	25.4 dB	28.4 dB
n260	21.5 dB	24.5 dB	27.5 dB	30.5 dB

**Table 6.3.3.4.5-3: Relaxations for ON power**

FFS

**6.3.3.5 Void****6.3.3.6 SRS time mask**

FFS

**6.3.3.7 PUSCH-PUCCH and PUSCH-SRS time masks**

No test case details are specified. Current test procedures for time masks are based on power measurement in relatively long period compared with transient period. For time masks between 2 active time slots with different power level, the test procedure can't provide enough resolution to identify non-conformant UEs. Therefore the minimum requirement is not testable.

**6.3.3.8 Transmit power time mask for consecutive slot or long subslot transmission and short subslot transmission boundaries**

No test case details are specified. Current test procedures for time masks are based on power measurement in relatively long period compared with transient period. For time masks between 2 active time slots with different power level, the test procedure can't provide enough resolution to identify non-conformant UEs. Therefore the minimum requirement is not testable.

**6.3.3.9 Transmit power time mask for consecutive short subslot transmissions boundaries**

No test case details are specified. Current test procedures for time masks are based on power measurement in relatively long period compared with transient period. For time masks between 2 active time slots with different power level, the test procedure can't provide enough resolution to identify non-conformant UEs. Therefore the minimum requirement is not testable.

**6.3.4 Power control****6.3.4.1 General**

The requirements on power control accuracy apply under normal conditions and are defined as a directional requirement. The requirements are verified in beam locked mode on beam peak direction.

**6.3.4.2 Absolute power tolerance**

**Editor's Note: The following aspects are either missing or not yet determined:**

- Testing of extreme conditions for FR2 is FFS.
- UE transmitted power for PC 1, 2 and 4 are FFS
- The reduction of the impact of DL MU by choosing  $\alpha < 1$  is FFS.

#### 6.3.4.2.1 Test purpose

To verify the UE's ability to transmit with a broadband output power below the value specified in the test requirement when the power is set to a minimum value.

To verify the ability of the UE transmitter to set its initial output power to a specific value at the start of a contiguous transmission or non-contiguous transmission with a long transmission gap, i.e. transmission gap is larger than 20 ms.

#### 6.3.4.2.2 Test applicability

This test case applies to all types of NR UE release 15 and forward.

#### 6.3.4.2.3 Minimum conformance requirements

The absolute power tolerance is the ability of the UE transmitter to set its initial output power to a specific value for the first sub-frame (1ms) at the start of a contiguous transmission or non-contiguous transmission with a transmission gap larger than 20 ms. The tolerance includes the channel estimation error RSRP estimate.

The minimum requirements specified in Table 6.3.4.2.3-1 apply in the power range bounded by the minimum output power as specified in sub-clause 6.3.1 ( $P_{min}$ ) and the maximum output power as specified in sub-clause 6.2.1.1 as minimum peak EIRP ( $P_{max}$ ). The intermediate power point ' $P_{int}$ ' is defined in table 6.3.4.2.3-2.

**Table 6.3.4.2.3-1: Absolute power tolerance**

Power Range	Tolerance
$P_{int} \geq P \geq P_{min}$	$\pm 14.0$ dB
$P_{max} \geq P > P_{int}$	$\pm 12.0$ dB

**Table 6.3.4.2.3-2: Intermediate power point**

Power Parameter	Value
$P_{int}$	$P_{max} - 12.0$ dB

The normative reference for this requirement is TS 38.101-2 [3] clause 6.3.4.2.

#### 6.3.4.2.4 Test description

##### 6.3.4.2.4.1 Initial condition

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, test channel bandwidths and sub-carrier spacing based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each combination of test channel bandwidth and sub-carrier spacing, and are shown in Table 6.3.4.2.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.3.4.2.4.1-1: Test Configuration Table**

Initial Conditions			
Test Environment as specified in TS 38.508-1 [10] subclause 4.1		Normal	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1		Mid range	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1		50 MHz, 100 MHz, 200 MHz, 400 MHz (NOTE 2)	
Test SCS as specified in Table 5.3.5-1.		Highest	
Test Parameters			
Test ID	Downlink Configuration		Uplink Configuration
	-		Modulation RB allocation (NOTE 1)



1		DFT-s-OFDM QPSK	Inner_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.			
NOTE 2: Test is required only for CBWs supported by the UE.			

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] clause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement Channel is set according to Table 6.3.4.2.4.1-1.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in State RRC\_CONNECTED with generic procedure parameters Connectivity NR, Connected without release On, Test Mode On and Test Loop Function On according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.3.4.2.4.3.

6.3.4.2.4.2 Test procedure

1. SS sends uplink scheduling information via PDCCH DCI format 0\_1 with TPC command 0dB for C\_RNTI to schedule the UL RMC according to Table 6.3.4.2.4.1-1. Since the UE has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC.
2. Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
3. Configure the UE transmitted output power to test point 1 in section 6.3.4.2.4.3. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
4. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
5. Measure UE EIRP of the first subframe in the Tx beam peak direction in the measurement bandwidth specified in Table 6.3.1.5-1 and Table 6.3.1.5-2 for the specific channel bandwidth under test. EIRP test procedure is defined in Annex K. The measuring duration is one active uplink subframe. EIRP is calculated considering both polarizations, theta and phi. For TDD slots with transient periods are not under test.
6. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.
7. Repeat test steps 1~6 for measurement of test point 2~3. The timing of the execution between the two test points shall be larger than 20ms.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

6.3.4.2.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with TRANSFORM\_PRECODER\_ENABLED condition in Table 4.6.3-118 PUSCH-Config and with following exceptions:

**Table 6.3.4.2.4.3-1: PUSCH-ConfigCommon (Test point 1) for power class 3**

Derivation Path: TS 38.508-1 [10], Table 4.6.3-119			
Information Element	Value/remark	Comment	Condition
PUSCH-ConfigCommon ::= SEQUENCE { p0-NominalWithGrant	-132		FR2a, 50MHz
	-134		FR2a, 100MHz
	-138		FR2a, 200MHz

	-140		FR2a, 400MHz
	-132		FR2b, 50MHz
	-134		FR2b, 100MHz
	-138		FR2b, 200MHz
	-140		FR2b, 400MHz
}			

**Table 6.3.4.2.4.3-2: PUSCH-ConfigCommon (Test point 2) for power class 3**

Derivation Path: TS 38.508-1 [10], Table 4.6.3-119			
Information Element	Value/remark	Comment	Condition
PUSCH-ConfigCommon ::= SEQUENCE {			
p0-NominalWithGrant	-108		FR2a, 50MHz
	-110		FR2a, 100MHz
	-114		FR2a, 200MHz
	-116		FR2a, 400MHz
	-110		FR2b, 50MHz
	-112		FR2b, 100MHz
	-116		FR2b, 200MHz
	-118		FR2b, 400MHz
}			

**Table 6.3.4.2.4.3-3: PUSCH-PowerControl (Test point 3) for power class 3**

Derivation Path: TS 38.508-1 [10], Table 4.6.3-119			
Information Element	Value/remark	Comment	Condition
PUSCH-ConfigCommon ::= SEQUENCE {			
p0-NominalWithGrant	-98		FR2a, 50MHz
	-102		FR2a, 100MHz
	-104		FR2a, 200MHz
	-106		FR2a, 400MHz
	-100		FR2b, 50MHz
	-104		FR2b, 100MHz
	-106		FR2b, 200MHz
	-108		FR2b, 400MHz
}			

**Table 6.3.4.2.4.3-4: ServingCellConfigCommon**

Derivation Path: 38.508-1[5], Table 4.6.3-168			
Information Element	Value/remark	Comment	Condition
ServingCellConfigCommon ::= SEQUENCE {			

ss-PBCH-BlockPower	4		SCS_120kHz
	7		SCS_240kHz
}			

Condition	Explanation
SCS_120kHz	SCS=120kHz for SS/PBCH block
SCS_240kHz	SCS=240kHz for SS/PBCH block

**Table 6.3.4.2.4.3-5: PUSCH-PowerControl**

Derivation Path: TS 38.508-1 [10], Table 4.6.3-120			
Information Element	Value/remark	Comment	Condition
PUSCH-PowerControl ::= SEQUENCE {			
tpc-Accumulation	disabled		
p0-AlphaSets SEQUENCE (SIZE (1..maxNrofP0-PUSCH-AlphaSets)) OF SEQUENCE {	1 entry		
P0-PUSCH-AlphaSet[1] SEQUENCE {			
alpha	alpha1		
}			
}			
}			

6.3.4.2.5 Test requirement

The measured EIRP in step 5 and 7 shall not to exceed the values specified in Table 6.3.4.2.5-1 to 6.3.4.2.5-3.

**Table 6.3.4.2.5-1: Absolute power tolerance: test point 1 for power class 3**

	Frequency range	Channel bandwidth / expected output power (dBm)			
		50 MHz	100 MHz	200 MHz	400 MHz
Expected Measured power	FR2a	-13.0	-12.0	-12.9	-12.8
	FR2b	-13.0	-12.0	-12.9	-12.8
Power tolerance (Note 2)		± (14+TT)dB			
Note 1: The higher power limit shall not exceed the Max EIRP defined in sub-clause 6.2.1.1.5.					
Note 2: Do not test lower limit.					

**Table 6.3.4.2.5-2: Absolute power tolerance: test point 2 for power class 3**

	Frequency range	Channel bandwidth / expected output power (dBm)			
		50 MHz	100 MHz	200 MHz	400 MHz
Expected Measured power	FR2a	11.0	12.0	11.1	11.2
	FR2b	9.0	10.0	9.1	9.2
Power tolerance (Note 2)		± (12+TT)dB			
Note 1: The lower power limit shall not exceed the minimum output power requirements defined in sub-clause 6.3.2.5, and the higher power limit shall not exceed the Max EIRP defined in sub-clause 6.2.1.1.5.					
Note 2: Do not test lower limit at CBW ≥ 200 MHz for FR2b					

**Table 6.3.4.2.5-3: Absolute power tolerance: test point 3 for power class 3**

	Frequency range	Channel bandwidth / expected output power (dBm)			
		50 MHz	100 MHz	200 MHz	400 MHz
Expected Measured power	FR2a	21.0	20.0	21.1	21.2
	FR2b	19.0	18.0	19.1	19.2

Power tolerance	$\pm (12+TT)$ dB
Note 1: The lower power limit shall not exceed the minimum output power requirements defined in sub-clause 6.3.2.5, and the higher power limit shall not exceed the Max EIRP defined in sub-clause 6.2.1.1.5.	

**Table 6.3.4.2.5-4: Test Tolerance for power class 1, 2, 4**

Test Metric	FR2a	FR2b
IFF (Max device size $\leq$ 30 cm)	Same as Table 6.3.1.5-3	Same as Table 6.3.1.5-3

**Table 6.3.4.2.5-5: Test Tolerance for power class 3**

Test Metric	NTC testing	ETC testing
IFF (Max device size $\leq$ 30 cm)	$\pm 8.05$ dB	$\pm 8.42$ dB

### 6.3.4.3 Relative power tolerance

*Editor’s note: This clause is incomplete. The following items are either missing or not yet determined:*

- MU and TT are TBD
- Starting power at ramp up/ramp down/alternating sub-test is TBD (6.3.4.3 MU dependent)
- Testability of test points needs further analysis, based on MU outcome

#### 6.3.4.3.1 Test purpose

To verify the ability of the UE transmitter to set its output power in a target sub-frame relatively to the power of the most recently transmitted reference sub-frame if the transmission gap between these sub-frames is less than or equal to 20 ms.

#### 6.3.4.3.2 Test applicability

This test case applies to all types of NR UE release 15 and forward.

#### 6.3.4.3.3 Minimum conformance requirements

The minimum requirements specified in Table 6.3.4.3.3-1 apply when the power of the target and reference sub-frames are within the power range bounded by the minimum output power as defined in sub-clause 6.3.1 and  $P_{int}$  as defined in sub-clause 6.3.4.2. The minimum requirements specified in Table 6.3.4.3.3-2 apply when the power of the target and reference sub-frames are within the power range bounded by  $P_{int}$  as defined in sub-clause 6.3.4.2 and the measured  $P_{UMAX}$  as defined in sub-clause 6.2.4.

For a test pattern that is either a monotonically increasing or monotonically decreasing power sweep over the range specified for Tables 6.3.4.3.3-1 and 6.3.4.3.3-2, 3 exceptions are allowed for each of the test patterns. For these exceptions, the power tolerance limit is a maximum of  $\pm 11.0$  dB.

**Table 6.3.4.3.3-1: Relative power tolerance,  $P_{int} \geq P \geq P_{min}$**

Power step $\Delta P$ (Up or down) (dB)	All combinations of PUSCH and PUCCH, PUSCH/PUCCH and SRS transitions between sub-frames, PRACH (dB)
$\Delta P < 2$	$\pm 5.0$
$2 \leq \Delta P < 3$	$\pm 6.0$
$3 \leq \Delta P < 4$	$\pm 7.0$
$4 \leq \Delta P < 10$	$\pm 8.0$
$10 \leq \Delta P < 15$	$\pm 10.0$
$15 \leq \Delta P$	$\pm 11.0$

NOTE: The requirements apply with *ue-BeamLockFunction* enabled.

**Table 6.3.4.3.3-2: Relative power tolerance,  $P_{UMAX} \geq P > P_{int}$**

Power step $\Delta P$ (Up or down) (dB)	All combinations of PUSCH and PUCCH, PUSCH/PUCCH and SRS transitions between subframes, PRACH (dB)
$\Delta P < 2$	$\pm 3.0$
$2 \leq \Delta P < 3$	$\pm 4.0$
$3 \leq \Delta P < 4$	$\pm 5.0$
$4 \leq \Delta P < 10$	$\pm 6.0$
$10 \leq \Delta P < 15$	$\pm 8.0$
$15 \leq \Delta P$	$\pm 9.0$
NOTE 1: The requirements apply with <i>ue-BeamLockFunction</i> enabled. NOTE 2: For PUSCH to PUSCH transitions with the allocated resource blocks fixed in frequency and no transmission gaps other than those generated by downlink subframes, guard periods: for a power step $\Delta P = 1$ dB, the relative power tolerance for transmission is $\pm 1.0$ dB.	

The normative reference for this requirement is TS 38.101-2 [3] clause 6.3.4.3.

6.3.4.3.4 Test description

6.3.4.3.4.1 Initial conditions

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, and channel bandwidths based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each channel bandwidth and subcarrier spacing, are shown in Table 6.3.4.3.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.3.4.3.4.1-1: Test Configuration Table**

Initial Conditions				
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1			Low Range	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1			100MHz	
Test SCS as specified in Table 5.3.5-1			Highest	
Test Parameters				
Ch BW	Downlink Configuration		Uplink Configuration	
	Modulation	RB Allocation	Modulation	RB allocation (NOTE 1)
100MHz	-		DFT-s-OFDM QPSK	See Table 6.3.4.3.5-1 See Table 6.3.4.3.5-2 See Table 6.3.4.3.5-3
Note 1: The starting resource block shall be RB# 44.				

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.

3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement channels are set according to Table 6.3.4.3.4.1-1.
5. Propagation conditions are set according to Annex B.0
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.3.4.3.4.3

6.3.4.3.4.2 Test procedure

The procedure is separated in various subtests to verify different aspects of relative power control. The power patterns of the subtests are described in Figure 6.3.4.3.4.2-1 through Figure 6.3.4.3.4.2-3. The power patterns and corresponding sub frame numberings are derived from Table A.2.3-1.

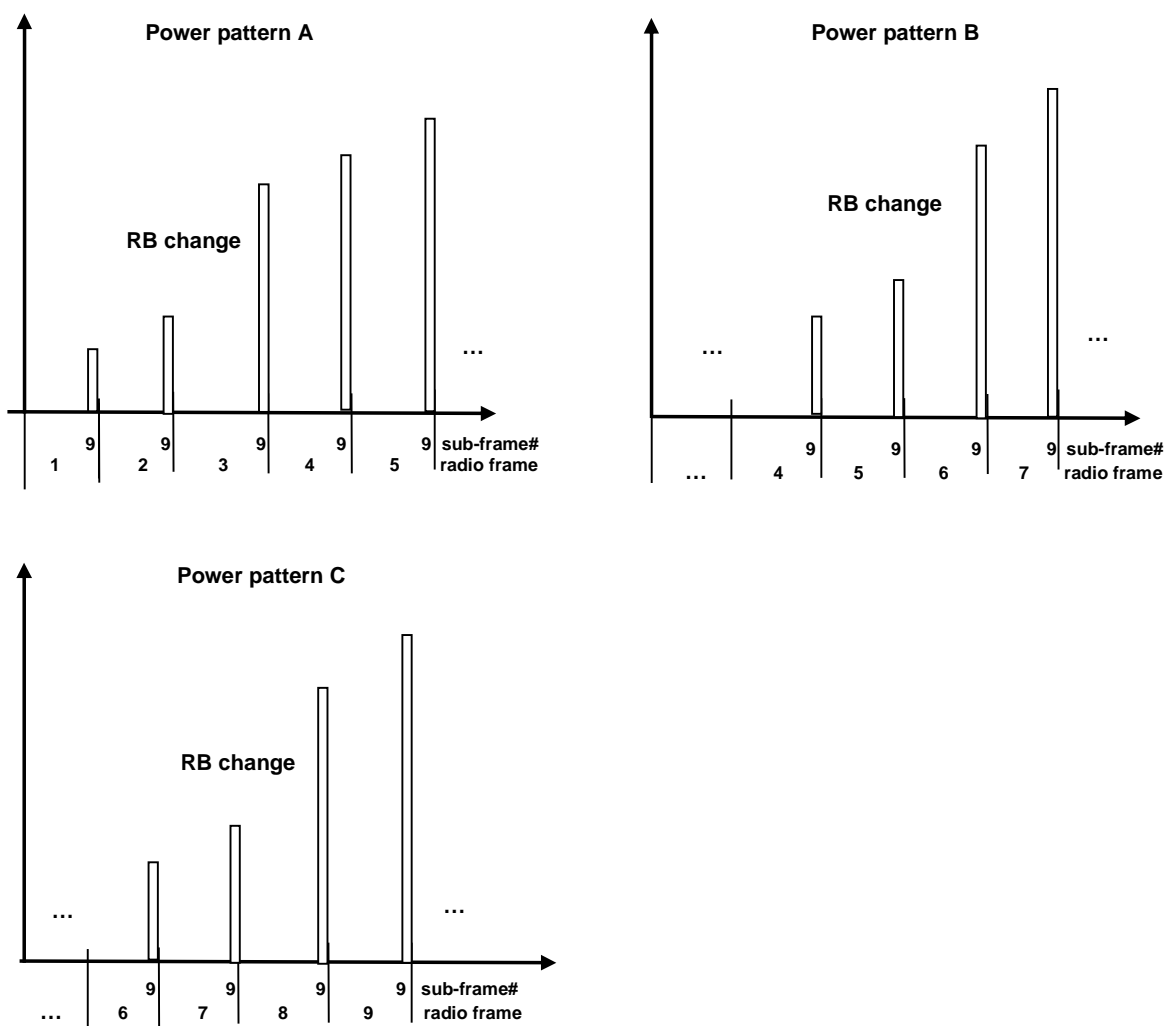


Figure 6.3.4.3.4.2-1: TDD ramping up test power patterns, SCS 60kHz

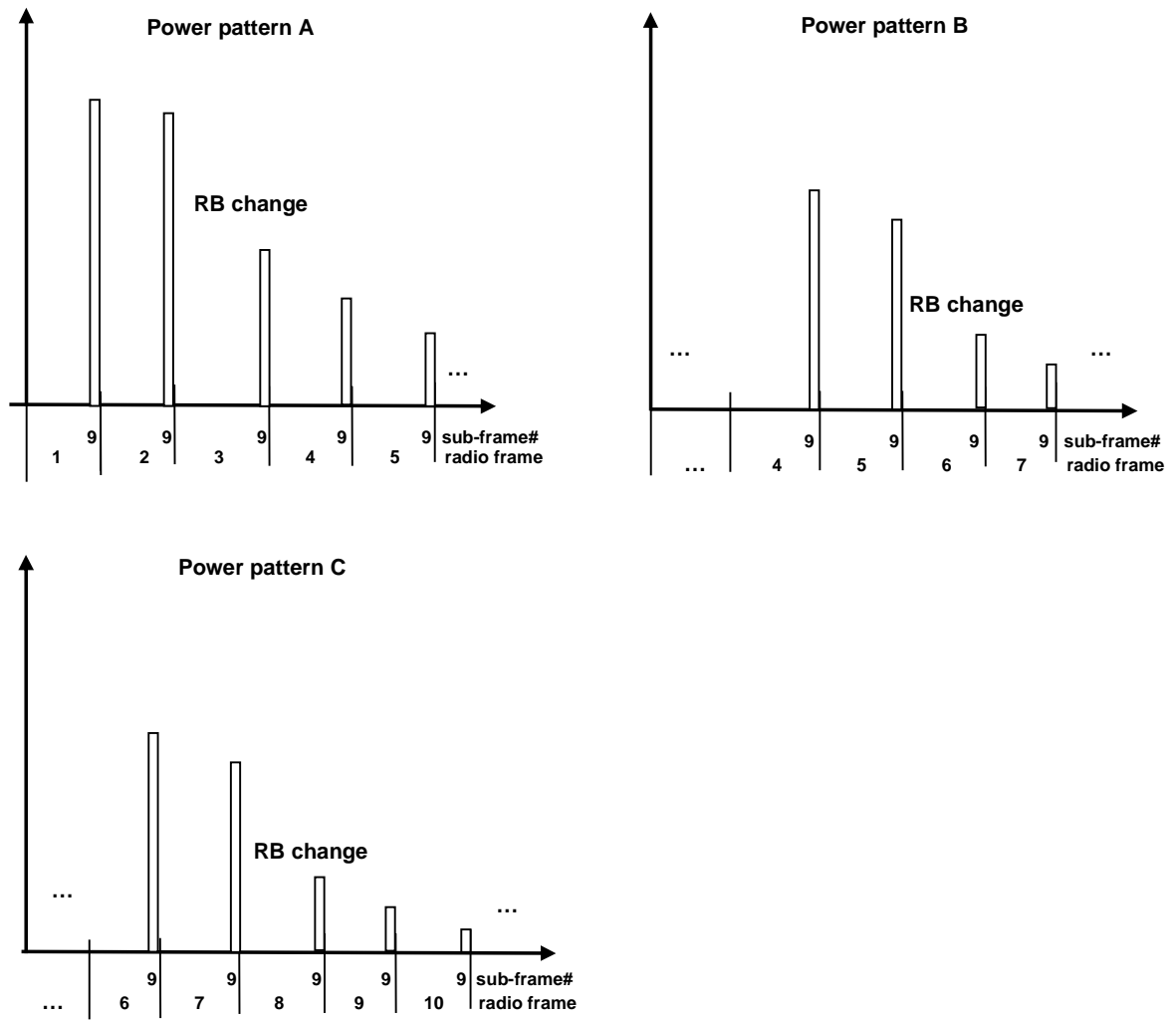


Figure 6.3.4.3.4.2-2: TDD ramping down test power patterns, SCS 60kHz

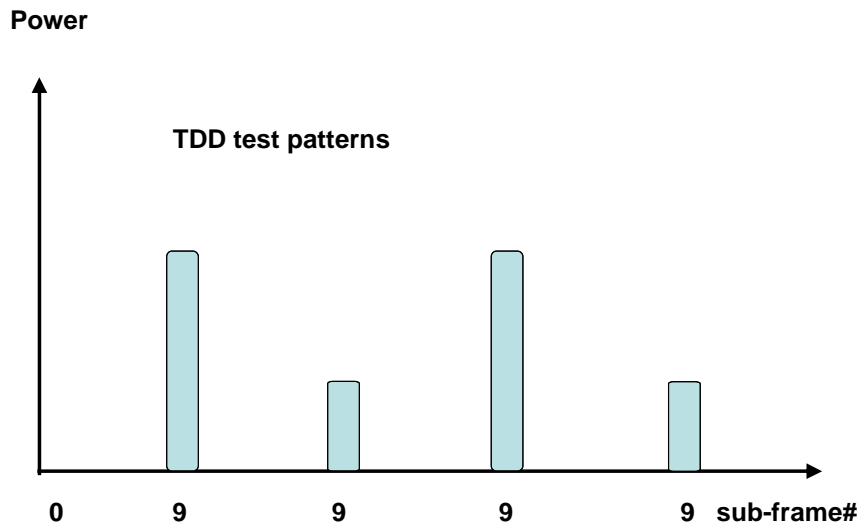


Figure 6.3.4.3.4.2-3: Alternating Test Power patterns, SCS 60kHz

1. Sub test: ramping up pattern

- 1.1 SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.3.4.3.4.1-1. Since the UE has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC.
- 1.2 Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
- 1.3 Send the appropriate TPC commands in the uplink scheduling information to UE until the UE EIRP measured by the test system is within the Uplink power control window, defined as  $+MU$  to  $+(MU + \text{Uplink power control window size})$  dB of the target power level  $P_{min}$ , where:
  - $P_{min}$  is the minimum output power according to subclause 6.3.1.3.
  - $MU$  is the test system uplink power measurement uncertainty and is specified in Table F.1.2-1 for the carrier frequency  $f$  and the channel bandwidth  $BW$ .
  - Uplink power control window size = 1dB (UE power step size) + 5dB (UE power step tolerance) + (Test system relative power measurement uncertainty), where, the UE power step tolerance is specified in TS 38.101-2 [3], Table 6.3.4.3-1 and is 5dB for 1dB power step size, and the Test system relative power measurement uncertainty is specified in Table F.1.2-1.

Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
- 1.4 SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
- 1.5 Schedule the UE's PUSCH data transmission as described in Figure 6.3.4.3.4.2-1 (TDD) pattern A: Uplink RB allocation as defined in Table 6.3.4.3.5-1. On the PDCCH format 0\_1 for the scheduling of the PUSCH the SS will transmit +1dB TPC commands over a sequence of 75 (NOTE 2) active uplink sub-frames to ensure that the UE reaches maximum power threshold. Note that the measurement need not be done continuously, provided that interruptions are whole numbers of frames, and TPC commands of 0dB are sent during the interruption.
- 1.6 Measure UE EIRP in the Tx beam peak direction in the channel bandwidth of the radio access mode according to the test configuration, to verify the UE relative power control meet test requirements in 6.3.4.3.5. EIRP test procedure is defined in Annex K.1.3. EIRP is calculated considering both polarizations, theta and phi. Measurement of the power is not required in sub-frame after the mean power has exceeded the



maximum power threshold. For power transients between sub-frames, transient periods of 40us between sub-frames are excluded. For ON/OFF or OFF/OFF transients, transient periods of 20 us at the beginning of the sub-frames are excluded.

1.7 Repeat the subtest different pattern B, C to move the RB allocation change at different points in the pattern as described in Table 6.3.4.3.5-1 to force different UE power steps at various points in the power range.

1.8 SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

## 2. Sub test: ramping down pattern

2.1 SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.3.4.3.4.1-1. Since the UE has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC.

2.2 Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.

2.3 Send the appropriate TPC commands in the uplink scheduling information to UE until the UE EIRP measured by the test system is within the Uplink power control window, defined as +MU to +(MU + Uplink power control window size) dB of the target power level  $P_{UMAX}$ , where:

- $P_{UMAX}$  is the maximum output power according to subclause 6.2.1.1.3.
- MU is the test system uplink power measurement uncertainty and is specified in Table F.1.2-1 for the carrier frequency  $f$  and the channel bandwidth BW.
- Uplink power control window size = 1dB (UE power step size) + 1dB (UE power step tolerance) + (Test system relative power measurement uncertainty), where, the UE power step tolerance is specified in TS 38.101-2 [3], Table 6.3.4.3-2 and is 1dB for 1dB power step size, and the Test system relative power measurement uncertainty is specified in Table F.1.2-1.

Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.

2.4 SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.

2.5. Schedule the UE's PUSCH data transmission as described in Figure 6.3.4.3.4.2-2 (TDD) pattern A: Uplink RB allocation as defined in Table 6.3.4.3.5-2. On the PDCCH format 0\_1 for the scheduling of the PUSCH the SS will transmit -1dB TPC commands over a sequence of 75 (NOTE 2) active uplink sub-frames to ensure that the UE reaches minimum power threshold. Note that the measurement need not be done continuously, provided that interruptions are whole numbers of frames, and TPC commands of 0dB are sent during the interruption.

2.6. Measure UE EIRP in the Tx beam peak direction in the channel bandwidth of the radio access mode according to the test configuration, to verify the UE relative power control meet test requirements in 6.3.4.3.5. EIRP test procedure is defined in Annex K.1.3. EIRP is calculated considering both polarizations, theta and phi. Measurement of the power is not required in sub-frame after the mean power has exceeded the maximum power threshold. For power transients between sub-frame, transient periods of 40us between sub-frame are excluded. For ON/OFF or OFF/OFF transients, transient periods of 20 us at the beginning of the sub-frame are excluded.

2.7. Repeat the subtest different pattern B, C to move the RB allocation change at different points in the pattern as described in Table 6.3.4.3.5-2 to force different UE power steps at various points in the power range.

2.8 SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

## 3. Sub test: alternating pattern

3.1 SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.3.4.3.4.1-1. Since the UE has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC. The initial uplink RB

allocation is defined as the smaller uplink RB allocation value specified in Table 6.3.4.3.4.1-1. The power level and RB allocation are reset for each sub-test.

- 3.2 Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
- 3.3 Send the appropriate TPC commands in the uplink scheduling information to UE until the UE EIRP measured by the test system is within the Uplink power control window, defined as +MU to +(MU + Uplink power control window size) dB of the target power level 0 dBm, where:
  - MU is the test system uplink power measurement uncertainty and is specified in Table F.1.2-1 for the carrier frequency f and the channel bandwidth BW.
  - Uplink power control window size is same as defined in step 1.3.

Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
- 3.4 SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
- 3.5. Schedule the UE's PUSCH data transmission as described in Figure 6.3.5.2.4.2-3 for 5 frames with an uplink RB allocation alternating pattern as defined in Table 6.3.4.3.5-3 while transmitting 0dB TPC command for PUSCH via the PDCCH.
- 3.6. Measure UE EIRP in the Tx beam peak direction in the channel bandwidth of the radio access mode according to the test configuration, to verify the UE relative power control meet test requirements in 6.3.4.3.5. EIRP test procedure is defined in Annex K.1.3. EIRP is calculated considering both polarizations, theta and phi. Measurement of the power is not required in sub-frame after the mean power has exceeded the maximum power threshold. For power transients between sub-frames, transient periods of 40us between sub-frames are excluded. For ON/OFF or OFF/ON transients, transient periods of 20 us at the beginning of the sub-frame are excluded.
- 3.7 SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

NOTE 2: These numbers of TPC commands are given as examples. The actual number of TPC commands transmitted in these steps shall be enough to ensure that the UE reaches the relevant maximum or minimum power threshold in each step, as shown in Figure 6.3.4.3.4.2-1 through 6.3.4.3.4.2-3.

6.3.4.3.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with TRANSFORM\_PRECODER\_ENABLED condition in Table 4.6.3-118 PUSCH-Config.

6.3.4.3.5 Test requirement

Each UE power step measured in the test procedure 6.3.4.3.4.2 should satisfy the test requirements specified in Table 6.3.4.3.5-1 through 6.3.4.3.5-3.

For a test pattern that is either a monotonically increasing or monotonically decreasing power sweep over the range specified for Tables 6.3.4.3.3-1 and 6.3.4.3.3-2, 3 exceptions are allowed for each of the test patterns. For these exceptions, the power tolerance limit is a maximum of ± (11.0 + TT) dB. If there is an exception in the power step caused by the RB change for all test patterns (A, B, C) then fail the UE.

**Table 6.3.4.3.5-1: Test Requirements Relative Power Tolerance for Transmission, channel BW 100MHz, SCS 60kHz, ramp up sub-test**

Sub-test ID	Applicable sub-frames	Uplink RB allocation	TPC command	Expected power step size (Up) ΔP [dB]	Power step size range (Up) ΔP [dB]	PUSCH [dB]
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1	Sub-frames before RB change	105RBs	TPC=+1dB	1	$\Delta P \leq 1 \text{ dB}$	1 +/- (1.0 + TT)
	RB change	105RBs to 128 RBs	TPC=+1dB	1.86	$\Delta P < 2 \text{ dB}$	1.86 +/- (5.0 + TT) (NOTE 1) 1.86 +/- (3.0 + TT) (NOTE 2)
	Sub-frames after RB change	Fixed = 128	TPC=+1dB	1	$\Delta P \leq 1 \text{ dB}$	1 +/- (1.0 + TT)
2	Sub-frames before RB change	90RBs	TPC=+1dB	1	$\Delta P \leq 1 \text{ dB}$	1 +/- (1.0 + TT)
	RB change	90RBs to 128 RBs	TPC=+1dB	2.53	$2 \text{ dB} \leq \Delta P < 3 \text{ dB}$	2.53 +/- (6.0 + TT) (NOTE 1) 2.53 +/- (4.0 + TT) (NOTE 2)
	Sub-frames after RB change	Fixed = 128	TPC=+1dB	1	$\Delta P \leq 1 \text{ dB}$	1 +/- (1.0 + TT)
3	Sub-frames before RB change	79RBs	TPC=+1dB	1	$\Delta P \leq 1 \text{ dB}$	1 +/- (1.0 + TT)
	RB change	79RBs to 128 RBs	TPC=+1dB	3.10	$3 \text{ dB} \leq \Delta P < 4 \text{ dB}$	3,10 +/- (7.0 + TT) (NOTE 1) 3,10 +/- (5.0 + TT) (NOTE 2)
	Sub-frames after RB change	Fixed = 128RBs	TPC=+1dB	1	$\Delta P \leq 1 \text{ dB}$	1 +/- (1.0 + TT)
4	Sub-frames before RB change	32RBs	TPC=+1dB	1	$\Delta P \leq 1 \text{ dB}$	1 +/- (1.0 + TT)
	RB change	32RBs to 128 RBs	TPC=+1dB	7.02	$4 \text{ dB} \leq \Delta P < 10 \text{ dB}$	7.02 +/- (8.0 + TT) (NOTE 1) 7.02 +/- (6.0 + TT) (NOTE 2)
	Sub-frames after RB change	Fixed = 128	TPC=+1dB	1	$\Delta P \leq 1 \text{ dB}$	1 +/- (1.0 + TT)
5	Sub-frames before RB change	7RBs	TPC=+1dB	1	$\Delta P \leq 1 \text{ dB}$	1 +/- (1.0 + TT)
	RB change	7RBs to 128 RBs	TPC=+1dB	13.62	$10 \text{ dB} \leq \Delta P < 15 \text{ dB}$	13.62 +/- (10.0 + TT) (NOTE 1) 13.62 +/- (8.0 + TT) (NOTE 2)
	Sub-frames after RB change	Fixed = 128RBs	TPC=+1dB	1	$\Delta P \leq 1 \text{ dB}$	1 +/- (1.0 + TT)
6	Sub-frames before RB change	1RB	TPC=+1dB	1	$\Delta P \leq 1 \text{ dB}$	1 +/- (1.0 + TT)
	RB change	1RB to 128 RBs	TPC=+1dB	22.07	$15 \text{ dB} < \Delta P$	22.07 +/- (11.0 + TT) (NOTE 1) 22.07 +/- (9.0 + TT) (NOTE 2)
	Sub-frames after RB change	Fixed = 128	TPC=+1dB	1	$\Delta P \leq 1 \text{ dB}$	1 +/- (1.0 + TT)

NOTE 1: Applicable if  $P_{int} \geq P \geq P_{min}$ .NOTE 2: Applicable if  $P_{UMAX} \geq P > P_{int}$ .NOTE 3: Applicable if  $P_{UMAX} \geq P \geq P_{min}$ .  $P_{min}$  as defined in sub-clause 6.3.1.

**Table 6.3.4.3.5-2: Test Requirements Relative Power Tolerance for Transmission, channel BW 100MHz, SCS 60kHz, ramp down sub-test**

Sub-test ID	Applicable sub-frames	Uplink RB allocation	TPC command	Expected power step size (Down) $\Delta P$ [dB]	Power step size range (Down) $\Delta P$ [dB]	PUSCH [dB]
1	Sub-frames before RB change	128RBs	TPC=-1dB	1	$\Delta P \leq 1$ dB	1 +/- (1.0 + TT)
	RB change	128RBs to 105 RBs	TPC=-1dB	1.86	$\Delta P < 2$ dB	1.86 +/- (5.0 + TT) (NOTE 1) 1.86 +/- (3.0 + TT) (NOTE 2)
	Sub-frames after RB change	Fixed = 105	TPC=-1dB	1	$\Delta P \leq 1$ dB	1 +/- (1.0 + TT)
2	Sub-frames before RB change	128RBs	TPC=-1dB	1	$\Delta P \leq 1$ dB	1 +/- (1.0 + TT)
	RB change	128RBs to 90 RBs	TPC=-1dB	2.53	$2\text{dB} \leq \Delta P < 3\text{dB}$	2.53 +/- (6.0 + TT) (NOTE 1) 2.53 +/- (4.0 + TT) (NOTE 2)
	Sub-frames after RB change	Fixed = 90	TPC=-1dB	1	$\Delta P \leq 1$ dB	1 +/- (1.0 + TT)
3	Sub-frames before RB change	128RBs	TPC=-1dB	1	$\Delta P \leq 1$ dB	1 +/- (1.0 + TT)
	RB change	128RBs to 79 RBs	TPC=-1dB	3.10	$3\text{dB} \leq \Delta P < 4\text{dB}$	3,10 +/- (7.0 + TT) (NOTE 1) 3,10 +/- (5.0 + TT) (NOTE 2)
	Sub-frames after RB change	Fixed = 79RBs	TPC=-1dB	1	$\Delta P \leq 1$ dB	1 +/- (1.0 + TT)
4	Sub-frames before RB change	128RBs	TPC=-1dB	1	$\Delta P \leq 1$ dB	1 +/- (1.0 + TT)
	RB change	128RBs to 32 RBs	TPC=-1dB	7.02	$4\text{dB} \leq \Delta P < 10\text{dB}$	7.02 +/- (8.0 + TT) (NOTE 1) 7.02 +/- (6.0 + TT) (NOTE 2)
	Sub-frames after RB change	Fixed = 32	TPC=-1dB	1	$\Delta P \leq 1$ dB	1 +/- (1.0 + TT)
5	Sub-frames before RB change	128RBs	TPC=-1dB	1	$\Delta P \leq 1$ dB	1 +/- (1.0 + TT)
	RB change	128RBs to 7 RBs	TPC=-1dB	13.62	$10\text{dB} \leq \Delta P < 15\text{dB}$	13.62 +/- (10.0 + TT) (NOTE 1) 13.62 +/- (8.0 + TT) (NOTE 2)
	Sub-frames after RB change	Fixed = 7RBs	TPC=-1dB	1	$\Delta P \leq 1$ dB	1 +/- (1.0 + TT)
6	Sub-frames before RB change	128RB	TPC=-1dB	1	$\Delta P \leq 1$ dB	1 +/- (1.0 + TT)
	RB change	128RB to 1 RBs	TPC=-1dB	22.07	$15\text{dB} < \Delta P$	22.07 +/- (11.0 + TT) (NOTE 1) 22.07 +/- (9.0 + TT) (NOTE 2)
	Sub-frames after RB	Fixed = 1	TPC=-1dB	1	$\Delta P \leq 1$ dB	1 +/- (1.0 + TT)

change					
NOTE 1: Applicable if $P_{int} \geq P \geq P_{min}$ .					
NOTE 2: Applicable if $P_{UMAX} \geq P > P_{int}$ .					
NOTE 3: Applicable if $P_{UMAX} \geq P \geq P_{min}$ . $P_{min}$ as defined in sub-clause 6.3.1.					

**Table 6.3.4.3.5-3: Test Requirements Relative Power Tolerance for Transmission, channel BW 100MHz, SCS 60kHz, alternating sub-test**

Sub-test ID	Uplink RB allocation	TPC command	Expected power step size (Up/Down) $\Delta P$ [dB]	Power step size range (Up/Down) $\Delta P$ [dB]	PUSCH [dB]
1	Alternating 105 and 128	TPC=0dB	0.86	$\Delta P < 2\text{dB}$	0.86 +/- (5.0 + TT) (NOTE 1) 0.86 +/- (3.0 + TT) (NOTE 2)
2	Alternating 79 and 128	TPC=0dB	2.10	$2\text{dB} \leq \Delta P < 3\text{dB}$	2.10 +/- (6.0 + TT) (NOTE 1) 2.10 +/- (4.0 + TT) (NOTE 2)
3	Alternating 64 and 128	TPC=0dB	3.01	$3\text{dB} \leq \Delta P < 4\text{dB}$	3.01 +/- (7.0 + TT) (NOTE 1) 3.01 +/- (5.0 + TT) (NOTE 2)
4	Alternating 32 and 128	TPC=0dB	6.02	$4\text{dB} \leq \Delta P < 10\text{dB}$	6.02 +/- (8.0 + TT) (NOTE 1) 6.02 +/- (6.0 + TT) (NOTE 2)
5	Alternating 7 and 128	TPC=0dB	12.62	$10\text{dB} \leq \Delta P < 15\text{dB}$	12.62 +/- (10.0 + TT) (NOTE 1) 12.62 +/- (8.0 + TT) (NOTE 2)
6	Alternating 1 and 128	TPC=0dB	21.07	$15\text{dB} < \Delta P$	21.07 +/- (11.0 + TT) (NOTE 1) 21.07 +/- (9.0 + TT) (NOTE 2)
NOTE 1: Applicable if $P_{int} \geq P \geq P_{min}$ .					
NOTE 2: Applicable if $P_{UMAX} \geq P > P_{int}$ .					
NOTE 3: Applicable if $P_{UMAX} \geq P \geq P_{min}$ . $P_{min}$ as defined in sub-clause 6.3.1.					

#### 6.3.4.4 Aggregate power tolerance

**Editor's Note:** The following aspects are either missing or not yet determined:

- UE transmitted power for power class 1, 2 and 4 is FFS.

##### 6.3.4.4.1 Test purpose

To verify the ability of the UE transmitter to maintain its power during non-contiguous transmissions within 21ms in response to 0 dB commands with respect to the first UE transmission and all other power control parameters as specified in TS 38.213 [22] kept constant.

##### 6.3.4.4.2 Test applicability

This test case applies to all types of NR UE release 15 and forward.

##### 6.3.4.4.3 Minimum conformance requirements

The aggregate power control tolerance is the ability of the UE transmitter to maintain its power in a sub-frame (1 ms) non-contiguous transmissions within 21ms in response to 0 dB TPC commands with respect to the first UE transmission and all other power control parameters as specified in TS 38.213 [22] kept constant.

The minimum requirements specified in Table 6.3.4.4.3-1 apply when the power of the target and reference sub-frames are within the power range bounded by the minimum output power as defined in sub-clause 6.3.1 and  $P_{int}$  as defined in sub-clause 6.3.4.2. The minimum requirements specified in Table 6.3.4.4.3-2 apply when the power of the target and reference sub-frames are within the power range bounded by  $P_{int}$  as defined in sub-clause 6.3.4.2 and the maximum output power as specified in sub-clause 6.2.1.

**Table 6.3.4.4.3-1: Aggregate power tolerance,  $P_{int} \geq P \geq P_{min}$**

TPC command	UL channel	Aggregate power tolerance within 21ms
0 dB	PUCCH	$\pm 5.5$ dB

0 dB	PUSCH	$\pm 5.5$ dB
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**Table 6.3.4.4.3-2: Aggregate power tolerance,  $P_{\max} \geq P > P_{\text{int}}$** 

TPC command	UL channel	Aggregate power tolerance within 21ms
0 dB	PUCCH	$\pm 3.5$ dB
0 dB	PUSCH	$\pm 3.5$ dB

The normative reference for this requirement is TS 38.101-2 [3] clause 6.3.4.4

#### 6.3.4.4.4 Test description

##### 6.3.4.4.4.1 Initial conditions

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, test channel bandwidths and sub-carrier spacing based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each combination of test channel bandwidth and sub-carrier spacing, and are shown in Table 6.3.4.4.4.1-1 and Table 6.3.4.4.4.1-2. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.3.4.4.4.1-1: Test Configuration Table: PUCCH subtest**

Initial Conditions		
Test Environment as specified in TS 38.508-1 [10] subclause 4.1	Normal	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1	Mid range	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1	Lowest, Mid and Highest	
Test SCS as specified in Table 5.3.5-1	Highest	
Test Parameters for Channel Bandwidths		
Test ID	Downlink Configuration	Uplink Configuration
	<b>Modulation</b>	<b>RB allocation</b>
1	CP-OFDM QPSK	Full RB (NOTE 1)
PUCCH format = Format 1 Length in OFDM symbols = 14		
NOTE 1: Full RB allocation shall be used per each SCS and channel BW as specified in Table 7.3.2.4.1-2.		

**Table 6.3.4.4.4.1-2: Test Configuration Table: PUSCH subtest**

Initial Conditions		
Test Environment as specified in TS 38.508-1 [10] subclause 4.1	Normal	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1	Mid range	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1	Lowest, Mid and Highest	
Test SCS as specified in Table 5.3.5-1	Highest	
Test Parameters for Channel Bandwidths		
Test ID	Downlink Configuration	Uplink Configuration
	-	<b>Modulation</b>
1		<b>RB allocation (NOTE 1)</b>
		DFT-s-OFDM QPSK
		Inner_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.		

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] clause 4.4.3.

3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. For PUCCH subtest, the UL and DL Reference Measurement Channels are set according to Table 6.3.4.4.4.1-1. For PUSCH subtest, the UL Reference Measurement Channel is set according to Table 6.3.4.4.4.1-2.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in State RRC\_CONNECTED with generic procedure parameters Connectivity NR, Connected without release On, Test Mode On and Test Loop Function On according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.3.4.4.4.3.

#### 6.3.4.4.4.2 Test procedure

The procedure is separated in two subtests to verify PUCCH and PUSCH aggregate power control tolerance respectively. The uplink transmission patterns are described in Figure 6.3.4.4.4.2-1.

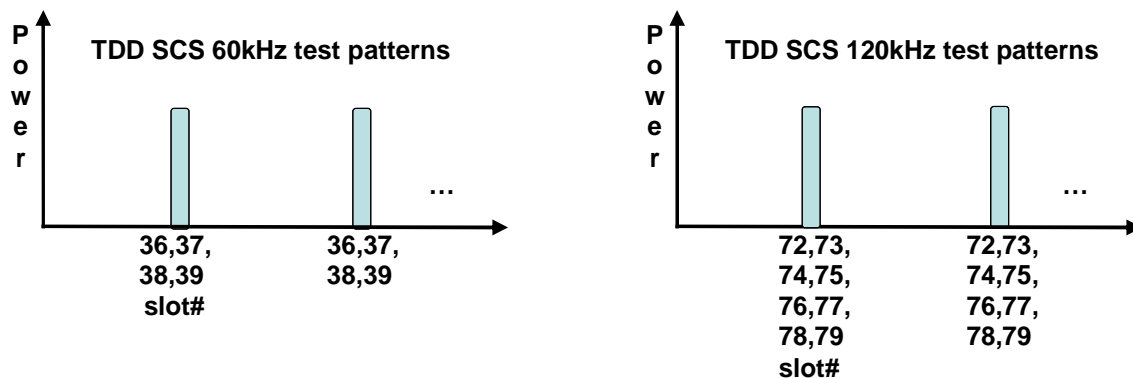


Figure 6.3.4.4.4.2-1: Test uplink transmission

##### 1. PUCCH subtest:

- 1.1. Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1.
- 1.2. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
- 1.3. The SS transmits PDSCH via PDCCH DCI format 1\_1 for C\_RNTI to transmit the DL RMC according to Table 6.3.4.4.4.1-1. The SS sends downlink MAC padding bits on the DL RMC. The transmission of PDSCH will make the UE send uplink ACK/NACK using PUCCH. Send uplink power control commands for PUCCH to the UE using 1dB power step size to ensure that the UE output power measured by the test system is within  $P_W$  of the target power level specified in Table 6.3.4.4.4.2-1 according to the power class with power ID = 1.  $P_W$  is the power window according to Table 6.3.4.4.4.2-2 for the carrier frequency  $f$  and the channel bandwidth BW.
- 1.4. Every 10 sub-frames (10ms) transmit to the UE downlink PDSCH MAC padding bits as well as 0 dB TPC command for PUCCH via the PDCCH to make the UE transmit ACK/NACK on the PUCCH for 1 sub-frame (1ms). The downlink transmission is scheduled in the appropriate slots to make the UE transmit PUCCH as described in Figure 6.3.4.4.4.2-1.
- 1.5. Measure the UE EIRP of 3 consecutive PUCCH transmissions in the Tx beam peak direction of in the measurement bandwidth specified in Table 6.3.1.5-1 and Table 6.3.1.5-2 to verify the UE transmitted PUCCH power is maintained within 21ms. EIRP test procedure is defined in Annex K. EIRP is calculated considering both polarizations, theta and phi. For TDD slots with transient periods are not under test.
- 1.6. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.
- 1.7. Repeat test steps 1.2 to 1.6 for measurement for power ID = 2 in Table 6.3.4.4.4.2-1.

##### 2. PUSCH subtest:

- 2.1. Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1.
- 2.2. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
- 2.3. The SS sends uplink scheduling information via PDCCH DCI format 0\_1 for C\_RNTI to schedule the PUSCH. Since the UE has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC. Send uplink power control commands for PUSCH to the UE using 1dB power step size to ensure that the UE output power measured by the test system is within  $P_w$  of the target power level specified in Table 6.3.4.4.2-1 according to the power class with power ID = 1.  $P_w$  is the power window according to Table 6.3.4.4.2-2 for the carrier frequency  $f$  and the channel bandwidth  $BW$ .
- 2.4. Every 10 sub-frames (10ms) schedule the UE's PUSCH data transmission for 1 sub-frame (1ms) and transmit 0 dB TPC command for PUSCH via the PDCCH to make the UE transmit PUSCH. The uplink transmission patterns are described in Figure 6.3.4.4.2-1.
- 2.5. Measure the UE EIRP of 3 consecutive PUSCH transmissions in the Tx beam peak direction of in the measurement bandwidth specified in Table 6.3.1.5-1 and Table 6.3.1.5-2 to verify the UE transmitted PUSCH power is maintained within 21ms. EIRP test procedure is defined in Annex K. EIRP is calculated considering both polarizations, theta and phi. For TDD slots with transient periods are not under test.
- 2.6. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.
- 2.7. Repeat test steps 2.2 to 2.6 for measurement for power ID = 2 in Table 6.3.4.4.2-1.

**Table 6.3.4.4.2-1: Parameters for Aggregate power tolerance**

	Power ID	Unit	PC1	PC2	PC3	PC4
FR2a	1	dBm	TBD	TBD	1	TBD
	2	dBm	TBD	TBD	15	TBD
FR2b	1	dBm	TBD	TBD	6	TBD
	2	dBm	TBD	TBD	15	TBD

**Table 6.3.4.4.2-2: Power Window (dB) for Aggregate Power tolerance for PUSCH and PUCCH**

Power ID	PUCCH	PUSCH
1	7.4	7.4
2	5.4	3.4

#### 6.3.4.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with TRANSFORM\_PRECODER\_ENABLED condition in Table 4.6.3-118 PUSCH-Config and with following exception:

**Table 6.3.4.4.3-1: Physical layer parameters for DCI format 1\_1 for PUCCH subtest**

Derivation Path: TS 38.508-1 [10], Table 5.4.2.0-1		
Parameter	Value	Value in binary
PUCCH resource indicator	$PUCCH-ResourceID[8] = 7$ in pucch-ResourceSetID[1] as defined in TS 38.508-1 [10], Table 4.6.3-112 (Mapping as per Table 9.2.3-2 in TS 38.213 [22])	'111'B

#### 6.3.4.4.5 Test requirement

The requirement for the power measurements made in step (1.5) and (2.5) of the test procedure shall not exceed the values specified in Table 6.3.4.4.5-1 and Table 6.3.4.4.5-2. The power measurement period shall be 1 sub-frame (1ms).



**Table 6.3.4.4.5-1: Power control tolerance ( $P_{int} \geq P \geq P_{min}$ )**

TPC command	UL channel	Test requirement measured power
0 dB	PUCCH	Given 3 power measurements in the pattern, the 2 <sup>nd</sup> , and later measurements shall be within $\pm(5.5\text{dB}+\text{TT})$ of the 1 <sup>st</sup> measurement.
0 dB	PUSCH	Given 3 power measurements in the pattern, the 2 <sup>nd</sup> , and later measurements shall be within $\pm(5.5\text{dB}+\text{TT})$ of the 1 <sup>st</sup> measurement.
Note 1: TT for each duplex, Sub-Carrier Spacing, frequency and channel bandwidth is specified in Table 6.3.4.4.5-3.		

**Table 6.3.4.4.5-2: Power control tolerance ( $P_{max} \geq P > P_{int}$ )**

TPC command	UL channel	Test requirement measured power
0 dB	PUCCH	Given 3 power measurements in the pattern, the 2 <sup>nd</sup> , and later measurements shall be within $\pm(3.5\text{dB}+\text{TT})$ of the 1 <sup>st</sup> measurement.
0 dB	PUSCH	Given 3 power measurements in the pattern, the 2 <sup>nd</sup> , and later measurements shall be within $\pm(3.5\text{dB}+\text{TT})$ of the 1 <sup>st</sup> measurement.
Note 1: TT for each duplex, Sub-Carrier Spacing, frequency and channel bandwidth is specified in Table 6.3.4.4.5-4.		

**Table 6.3.4.4.5-3: Test Tolerance ( $P_{int} \geq P \geq P_{min}$ )**

Test Metric	FR2a	FR2b
IFF (Max device size $\leq 30$ cm)	0.26 dB	0.26 dB

**Table 6.3.4.4.5-4: Test Tolerance ( $P_{max} \geq P > P_{int}$ )**

Test Metric	FR2a	FR2b
IFF (Max device size $\leq 30$ cm)	0.26 dB	0.26 dB

## 6.3A Output power dynamics for CA

### 6.3A.1 Minimum output power for CA

#### 6.3A.1.0 Minimum conformance requirements

For intra-band contiguous carrier aggregation, the minimum controlled output power of the UE is defined as the transmit power of the UE per component carrier, i.e., EIRP in the channel bandwidth of each component carrier for all transmit bandwidth configurations (resource blocks), when the power on both component carriers are set to a minimum value.

The minimum output power is defined as the mean power in at least one subframe (1ms).

The minimum output power shall not exceed the values specified in Table 6.3A.1.0-1 and 6.3A.1.0-2 for each operating band supported. The minimum power is verified in beam locked mode with the test metric of EIRP (Link=TX beam peak direction, Meas=Link angle).

**Table 6.3A.1.0-1: Minimum output power for CA for power class 1**

Operating band	Channel bandwidth (MHz)	Minimum output power (dBm)	Measurement bandwidth (MHz)
n257, n258, n260, n261	50	4	47.58

	100	4	95.16
	200	4	190.20
	400	4	380.28

**Table 6.3A.1.0-2: Minimum output power for CA for power class 2, 3 and 4**

Operating band	Channel bandwidth (MHz)	Minimum output power (dBm)	Measurement bandwidth (MHz)
n257, n258, n260, n261	50	-13	47.58
	100	-13	95.16
	200	-13	190.20
	400	-13	380.28
NOTE 1: n260 is not applied for power class 2.			

The normative reference for this requirement is TS 38.101-2 [3] clause 6.3A.1.

### 6.3A.1.1 Minimum output power for CA (2UL CA)

**Editor's Note: The following aspects are either missing or not yet determined:**

- Relaxation, Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.
- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 800MHz is FFS as test system complexity might increase.

#### 6.3A.1.1.1 Test purpose

To verify the UE's ability to transmit with a broadband output power below the value specified in the test requirement when the power on each component carrier is set to a minimum value.

#### 6.3A.1.1.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that support intra-band contiguous 2UL CA.

#### 6.3A.1.1.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.3A.1.0.

#### 6.3A.1.1.4 Test description

##### 6.3A.1.1.4.1 Initial condition

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, test channel bandwidths and sub-carrier spacing based on NR CA configuration specified in clause 5.5A. All of these configurations shall be tested with applicable test parameters for each CA configuration, and are shown in Table 6.3A.1.1.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.3A.1.1.4.1-1: Test Configuration Table**

Default Conditions	
Test Environment as specified in TS 38.508-1 [10] subclause 4.1	Normal
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.	Low and High range
Test CC combination setting as specified TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across	Lowest aggregated BW of the CA configuration Highest aggregated BW of the CA configuration

bandwidth combination sets supported by the UE.						
Test SCS as specified in Table 5.3.5-1.		Highest				
Test Parameters						
Test ID	CC	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation
1	PCC	Default	Default	-	DFT-s-OFDM QPSK	Outer_Full
	SCC				DFT-s-OFDM QPSK	Outer_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.						
NOTE 2: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: <i>“The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier”.</i>						

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] clause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement Channel is set according to Table 6.3A.1.1.4.1-1.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in State RRC\_CONNECTED with generic procedure parameters Connectivity NR, Connected without release On, Test Mode On and Test Loop Function On according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.3A.1.1.4.3.

#### 6.3A.1.1.4.2 Test procedure

1. Configure SCC according to Annex C.0, C.1, C.3.0 for all downlink physical channels.
2. The SS shall configure SCC as per TS 38.508-1 [10] clause 5.5.1. Message contents are defined in clause 6.3A.1.1.4.3
3. SS activates SCC by sending the activation MAC CE (Refer TS 38.321 [28], clauses 5.9, 6.1.3.10). Wait for at least 2 seconds (Refer TS 38.133[25], clause 9.2).
4. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.3A.1.1.4.1-1 on both PCC and SCC. Since the UE has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC.
5. Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
6. Send continuously uplink power control "down" commands in every uplink scheduling information to the UE; allow at least 200ms starting from the first TPC command in this step to ensure that the UE transmits at its minimum output power. If UE is disconnected, repeat the test case. Optionally, send continuously uplink power control "down" commands in every uplink scheduling information to the UE until the UE EIRP measured by the test system is at a level just before the UE was disconnected. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
7. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
8. Measure UE EIRP of each component carrier in the Tx beam peak direction in the measurement bandwidth specified in Table 6.3A.1.1.5-1 for the specific channel bandwidth under test. EIRP test procedure is defined in Annex K. The measuring duration is at least one active uplink subframe. EIRP is calculated considering both polarizations, theta and phi. For TDD slots with transient periods are not under test.

9. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

#### 6.3A.1.1.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with following exception.

**Table 6.3A.1.1.4.3-1: PUSCH-Config**

Derivation Path: TS 38.508-1 [10], Table 4.6.3-118 with condition TRANSFORM\_PRECODER\_ENABLED

#### 6.3A.1.1.5 Test requirement

For each component carrier, the minimum EIRP shall not exceed the values specified in Table 6.3A.1.1.5-1 and 6.3A.1.1.5-2.

**Table 6.3A.1.1.5-1: Minimum output power for 2UL CA for power class 1**

Operating band	Channel bandwidth (MHz)	Minimum output power (dBm)	Measurement bandwidth (MHz)
n257, n258, n260, n261	50	4+TBD+TT	47.58
	100	4+TBD+TT	95.16
	200	4+TBD+TT	190.20
	400	4+TBD+TT	380.28

**Table 6.3A.1.1.5-2: Minimum output power for 2UL CA for power class 3**

Operating band	Channel bandwidth (MHz)	Minimum output power (dBm)	Measurement bandwidth (MHz)
n257, n258, n261	50	-13+TT	47.58
	100	-13+2.4+TT	95.16
	200	-13+5.4+TT	190.20
	400	-13+8.4+TT	380.28
n260	50	-13+4.5+TT	47.58
	100	-13+7.5+TT	95.16
	200	-13+10.5+TT	190.20
	400	-13+13.5+TT	380.28

NOTE 1: n260 is not applied for power class 2.

**Table 6.3A.1.1.5-2a: Minimum output power for 2UL CA for power class 2 and 4**

Operating band	Channel bandwidth (MHz)	Minimum output power (dBm)	Measurement bandwidth (MHz)
n257, n258, n260, n261	50	-13+TBD+TT	47.58
	100	-13+TBD+TT	95.16
	200	-13+TBD+TT	190.20
	400	-13+TBD+TT	380.28

NOTE 1: n260 is not applied for power class 2.

**Table 6.3A.1.1.5-3: Test Tolerance for Minimum output power for 2UL CA for Power class 1, 2, 4**

Test Metric	FR2a	FR2b
Max device size ≤ 30 cm	FFS	FFS

**Table 6.3A.1.1.5-4: Test Tolerance for Minimum output power for 2UL CA for Power class 3**

Test Metric	FR2a	FR2b
Max device size $\leq$ 30 cm	Same as in table 6.3.1.5-2	Same as in table 6.3.1.5-2

### 6.3A.1.2 Minimum output power for CA (3UL CA)

Editor's note: The following aspects are either missing or not yet determined:

- Relaxation, Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.
- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 800MHz is FFS as test system complexity might increase.

#### 6.3A.1.2.1 Test purpose

To verify the UE's ability to transmit with a broadband output power below the value specified in the test requirement when the power on each component carrier is set to a minimum value.

#### 6.3A.1.2.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 3UL CA.

#### 6.3A.1.2.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.3A.1.0.

#### 6.3A.1.2.4 Test description

Same as in clause 6.3A.1.1.4 with following exceptions:

- Instead of Table 6.3A.1.1.4.1-1  $\rightarrow$  use Table 6.3A.1.2.4-1.
- Instead of Table 6.3A.1.1.5-1 and 6.3A.1.1.5-2  $\rightarrow$  use Table 6.3A.1.2.5-1 and 6.3A.1.2.5-2.

**Table 6.3A.1.2.4-1: Test Configuration Table for 3UL CA**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.				Low and High range		
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.				Lowest aggregated BW of the CA configuration Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1.				Highest		
Test Parameters						
Test ID	CC	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation
1	PCC	Default	Default	-	DFT-s-OFDM QPSK	Outer_Full
	SCC1				DFT-s-OFDM QPSK	Outer_Full
	SCC2				DFT-s-OFDM QPSK	Outer_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.						
NOTE 2: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".						

## 6.3A.1.2.5 Test requirement

For each component carrier, the minimum EIRP shall not exceed the values specified in Table 6.3A.1.2.5-1 and 6.3A.1.2.5-2.

**Table 6.3A.1.2.5-1: Minimum output power for 3UL CA for power class 1**

Operating band	Channel bandwidth (MHz)	Minimum output power (dBm)	Measurement bandwidth (MHz)
n257, n258, n260, n261	50	4+TBD+TT	47.58
	100	4+TBD+TT	95.16
	200	4+TBD+TT	190.20
	400	4+TBD+TT	380.28

**Table 6.3A.1.2.5-2: Minimum output power for 3UL CA for power class 3**

Operating band	Channel bandwidth (MHz)	Minimum output power (dBm)	Measurement bandwidth (MHz)
n257, n258, n261	50	-13+TT	47.58
	100	-13+2.4+TT	95.16
	200	-13+5.4+TT	190.20
	400	-13+8.4+TT	380.28
n260	50	-13+4.5+TT	47.58
	100	-13+7.5+TT	95.16
	200	-13+10.5+TT	190.20
	400	-13+13.5+TT	380.28

NOTE 1: n260 is not applied for power class 2.

**Table 6.3A.1.2.5-2a: Minimum output power for 3UL CA for power class 2 and 4**

Operating band	Channel bandwidth (MHz)	Minimum output power (dBm)	Measurement bandwidth (MHz)
n257, n258, n260, n261	50	-13+TBD+TT	47.58
	100	-13+TBD+TT	95.16
	200	-13+TBD+TT	190.20
	400	-13+TBD+TT	380.28

NOTE 1: n260 is not applied for power class 2.

**Table 6.3A.1.2.5-3: Test Tolerance for Minimum output power for 3UL CA for Power class 1, 2, 4**

Test Metric	FR2a	FR2b
Max device size ≤ 30 cm	FFS	FFS

**Table 6.3A.1.2.5-4: Test Tolerance for Minimum output power for 3UL CA for Power class 3**

Test Metric	FR2a	FR2b
Max device size ≤ 30 cm	Same as in table 6.3.1.5-2	Same as in table 6.3.1.5-2

## 6.3A.1.3 Minimum output power for CA (4UL CA)

Editor's note: The following aspects are either missing or not yet determined:

- Relaxation, Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.
- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 800MHz is FFS as test system complexity might increase.

## 6.3A.1.3.1 Test purpose

To verify the UE's ability to transmit with a broadband output power below the value specified in the test requirement when the power on each component carrier is set to a minimum value.

## 6.3A.1.3.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 4UL CA.

## 6.3A.1.3.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.3A.1.0.

## 6.3A.1.3.4 Test description

Same as in clause 6.3A.1.1.4 with following exceptions:

- Instead of Table 6.3A.1.1.4.1-1 → use Table 6.3A.1.3.4-1.
- Instead of Table 6.3A.1.1.5-1 and 6.3A.1.1.5-2 → use Table 6.3A.1.3.5-1 and 6.3A.1.3.5-2.

**Table 6.3A.1.3.4-1: Test Configuration Table for 4UL CA**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.				Low and High range		
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.				Lowest aggregated BW of the CA configuration Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1.				Highest		
Test Parameters						
Test ID	CC	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation
1	PCC	Default	Default	-	DFT-s-OFDM QPSK	Outer_Full
	SCC1				DFT-s-OFDM QPSK	Outer_Full
	SCC2				DFT-s-OFDM QPSK	Outer_Full
	SCC3				DFT-s-OFDM QPSK	Outer_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.						
NOTE 2: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: " <i>The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier</i> ".						

## 6.3A.1.3.5 Test requirement

For each component carrier, the minimum EIRP shall not exceed the values specified in Table 6.3A.1.3.5-1 and 6.3A.1.3.5-2.

**Table 6.3A.1.3.5-1: Minimum output power for 4UL CA for power class 1**

Operating band	Channel bandwidth (MHz)	Minimum output power (dBm)	Measurement bandwidth (MHz)
n257, n258, n260, n261	50	4+TBD+TT	47.58
	100	4+TBD+TT	95.16
	200	4+TBD+TT	190.20
	400	4+TBD+TT	380.28

**Table 6.3A.1.3.5-2: Minimum output power for 4UL CA for power class 3**

Operating band	Channel bandwidth (MHz)	Minimum output power (dBm)	Measurement bandwidth (MHz)
n257, n258, n261	50	-13+TT	47.58
	100	-13+2.4+TT	95.16
	200	-13+5.4+TT	190.20
	400	-13+8.4+TT	380.28
n260	50	-13+4.5+TT	47.58
	100	-13+7.5+TT	95.16
	200	-13+10.5+TT	190.20
	400	-13+13.5+TT	380.28

NOTE 1: n260 is not applied for power class 2.

**Table 6.3A.1.3.5-2a: Minimum output power for 4UL CA for power class 2 and 4**

Operating band	Channel bandwidth (MHz)	Minimum output power (dBm)	Measurement bandwidth (MHz)
n257, n258, n260, n261	50	-13+TBD+TT	47.58
	100	-13+TBD+TT	95.16
	200	-13+TBD+TT	190.20
	400	-13+TBD+TT	380.28

NOTE 1: n260 is not applied for power class 2.

**Table 6.3A.1.3.5-3: Test Tolerance for Minimum output power for 4UL CA for Power class 1, 2, 4**

Test Metric	FR2a	FR2b
Max device size ≤ 30 cm	FFS	FFS

**Table 6.3A.1.3.5-4: Test Tolerance for Minimum output power for 4UL CA for Power class 3**

Test Metric	FR2a	FR2b
Max device size ≤ 30 cm	Same as in table 6.3.1.5-2	Same as in table 6.3.1.5-2

### 6.3A.1.4 Minimum output power for CA (5UL CA)

Editor's note: The following aspects are either missing or not yet determined:

- Relaxation, Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.
- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 800MHz is FFS as test system complexity might increase.

#### 6.3A.1.4.1 Test purpose

To verify the UE's ability to transmit with a broadband output power below the value specified in the test requirement when the power on each component carrier is set to a minimum value.

#### 6.3A.1.4.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 5UL CA.

#### 6.3A.1.4.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.3A.1.0.



## 6.3A.1.4.4 Test description

Same as in clause 6.3A.1.1.4 with following exceptions:

- Instead of Table 6.3A.1.1.4.1-1 → use Table 6.3A.1.4.4-1.
- Instead of Table 6.3A.1.1.5-1 and 6.3A.1.1.5-2 → use Table 6.3A.1.4.5-1 and 6.3A.1.4.5-2.

**Table 6.3A.1.4.4-1: Test Configuration Table for 5UL CA**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.				Low and High range		
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.				Lowest aggregated BW of the CA configuration Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1.				Highest		
Test Parameters						
Test ID	CC	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation
1	PCC	Default	Default	-	DFT-s-OFDM QPSK	Outer_Full
	SCC1				DFT-s-OFDM QPSK	Outer_Full
	SCC2				DFT-s-OFDM QPSK	Outer_Full
	SCC3				DFT-s-OFDM QPSK	Outer_Full
	SCC4				DFT-s-OFDM QPSK	Outer_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.						
NOTE 2: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".						

## 6.3A.1.4.5 Test requirement

For each component carrier, the minimum EIRP shall not exceed the values specified in Table 6.3A.1.4.5-1 and 6.3A.1.4.5-2.

**Table 6.3A.1.4.5-1: Minimum output power for 5UL CA for power class 1**

Operating band	Channel bandwidth (MHz)	Minimum output power (dBm)	Measurement bandwidth (MHz)
n257, n258, n260, n261	50	4+TBD+TT	47.58
	100	4+TBD+TT	95.16
	200	4+TBD+TT	190.20
	400	4+TBD+TT	380.28

**Table 6.3A.1.4.5-2: Minimum output power for 5UL CA for power class 3**

Operating band	Channel bandwidth (MHz)	Minimum output power (dBm)	Measurement bandwidth (MHz)
n257, n258, n261	50	-13+TT	47.58
	100	-13+2.4+TT	95.16
	200	-13+5.4+TT	190.20
	400	-13+8.4+TT	380.28
n260	50	-13+4.5+TT	47.58
	100	-13+7.5+TT	95.16

	200	-13+10.5+TT	190.20
	400	-13+13.5+TT	380.28
NOTE 1: n260 is not applied for power class 2.			

**Table 6.3A.1.4.5-2a: Minimum output power for 5UL CA for power class 2 and 4**

Operating band	Channel bandwidth (MHz)	Minimum output power (dBm)	Measurement bandwidth (MHz)
n257, n258, n260, n261	50	-13+TBD+TT	47.58
	100	-13+TBD+TT	95.16
	200	-13+TBD+TT	190.20
	400	-13+TBD+TT	380.28
NOTE 1: n260 is not applied for power class 2.			

**Table 6.3A.1.4.5-3: Test Tolerance for Minimum output power for 5UL CA for Power class 1, 2, 4**

Test Metric	FR2a	FR2b
Max device size $\leq$ 30 cm	FFS	FFS

**Table 6.3A.1.4.5-4: Test Tolerance for Minimum output power for 5UL CA for Power class 3**

Test Metric	FR2a	FR2b
Max device size $\leq$ 30 cm	Same as in table 6.3.1.5-2	Same as in Table 6.3.1.5-2

### 6.3A.1.5 Minimum output power for CA (6UL CA)

Editor's note: The following aspects are either missing or not yet determined:

- Relaxation, Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.
- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 800MHz is FFS as test system complexity might increase.

#### 6.3A.1.5.1 Test purpose

To verify the UE's ability to transmit with a broadband output power below the value specified in the test requirement when the power on each component carrier is set to a minimum value.

#### 6.3A.1.5.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 6UL CA.

#### 6.3A.1.5.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.3A.1.0.

#### 6.3A.1.5.4 Test description

Same as in clause 6.3A.1.1.4 with following exceptions:

- Instead of Table 6.3A.1.1.4.1-1  $\rightarrow$  use Table 6.3A.1.5.4-1.
- Instead of Table 6.3A.1.1.5-1 and 6.3A.1.1.5-2  $\rightarrow$  use Table 6.3A.1.5.5-1 and 6.3A.1.5.5-2.

**Table 6.3A.1.5.4-1: Test Configuration Table for 6UL CA**

Default Conditions	
Test Environment as specified in TS 38.508-1 [10]	Normal

subclause 4.1						
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.		Low and High range				
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.		Lowest aggregated BW of the CA configuration Highest aggregated BW of the CA configuration				
Test SCS as specified in Table 5.3.5-1.		Highest				
Test Parameters						
Test ID	CC	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation
1	PCC	Default	Default	-	DFT-s-OFDM QPSK	Outer_Full
	SCC1				DFT-s-OFDM QPSK	Outer_Full
	SCC2				DFT-s-OFDM QPSK	Outer_Full
	SCC3				DFT-s-OFDM QPSK	Outer_Full
	SCC4				DFT-s-OFDM QPSK	Outer_Full
	SCC5				DFT-s-OFDM QPSK	Outer_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.						
NOTE 2: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".						

#### 6.3A.1.5.5 Test requirement

For each component carrier, the minimum EIRP shall not exceed the values specified in Table 6.3A.1.5.5-1 and 6.3A.1.5.5-2.

**Table 6.3A.1.5.5-1: Minimum output power for 6UL CA for power class 1**

Operating band	Channel bandwidth (MHz)	Minimum output power (dBm)	Measurement bandwidth (MHz)
n257, n258, n260, n261	50	4+TBD+TT	47.58
	100	4+TBD+TT	95.16
	200	4+TBD+TT	190.20
	400	4+TBD+TT	380.28

**Table 6.3A.1.5.5-2: Minimum output power for 6UL CA for power class 3**

Operating band	Channel bandwidth (MHz)	Minimum output power (dBm)	Measurement bandwidth (MHz)
n257, n258, n261	50	-13+TT	47.58
	100	-13+2.4+TT	95.16
	200	-13+5.4+TT	190.20
	400	-13+8.4+TT	380.28
n260	50	-13+4.5+TT	47.58
	100	-13+7.5+TT	95.16
	200	-13+10.5+TT	190.20
	400	-13+13.5+TT	380.28

NOTE 1: n260 is not applied for power class 2.

**Table 6.3A.1.5.5-2a: Minimum output power for 6UL CA for power class 2 and 4**

Operating band	Channel bandwidth (MHz)	Minimum output power (dBm)	Measurement bandwidth (MHz)
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n257, n258, n260, n261	50	-13+TBD+TT	47.58
	100	-13+TBD+TT	95.16
	200	-13+TBD+TT	190.20
	400	-13+TBD+TT	380.28
NOTE 1: n260 is not applied for power class 2.			

**Table 6.3A.1.5.5-3: Test Tolerance for Minimum output power for 6UL CA for Power class 1, 2, 4**

Test Metric	FR2a	FR2b
Max device size ≤ 30 cm	FFS	FFS

**Table 6.3A.1.5.5-4: Test Tolerance for Minimum output power for 6UL CA for Power class 3**

Test Metric	FR2a	FR2b
Max device size ≤ 30 cm	Same as in table 6.3.1.5-2	Same as in table 6.3.1.5-2

**6.3A.1.6 Minimum output power for CA (7UL CA)**

*Editor’s note: The following aspects are either missing or not yet determined:*

- Relaxation, Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.
- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 800MHz is FFS as test system complexity might increase.

**6.3A.1.6.1 Test purpose**

To verify the UE's ability to transmit with a broadband output power below the value specified in the test requirement when the power on each component carrier is set to a minimum value.

**6.3A.1.6.2 Test applicability**

This test case applies to all types of NR UE release 15 and forward that supports FR2 7UL CA.

**6.3A.1.6.3 Minimum conformance requirements**

The minimum conformance requirements are defined in clause 6.3A.1.0.

**6.3A.1.6.4 Test description**

Same as in clause 6.3A.1.1.4 with following exceptions:

- Instead of Table 6.3A.1.1.4.1-1 → use Table 6.3A.1.6.4-1.
- Instead of Table 6.3A.1.1.5-1 and 6.3A.1.1.5-2 → use Table 6.3A.1.6.5-1 and 6.3A.1.6.5-2.

**Table 6.3A.1.6.4-1: Test Configuration Table for 7UL CA**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal			
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.			Low and High range			
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.			Lowest aggregated BW of the CA configuration Highest aggregated BW of the CA configuration			
Test SCS as specified in Table 5.3.5-1.			Highest			
Test Parameters						
Test	CC	ChBw(MHz)	Test frequency	DL RB	UL Modulation	UL RB allocation

ID				allocation		
1	PCC	Default	Default	-	DFT-s-OFDM QPSK	Outer_Full
	SCC1				DFT-s-OFDM QPSK	Outer_Full
	SCC2				DFT-s-OFDM QPSK	Outer_Full
	SCC3				DFT-s-OFDM QPSK	Outer_Full
	SCC4				DFT-s-OFDM QPSK	Outer_Full
	SCC5				DFT-s-OFDM QPSK	Outer_Full
	SCC6				DFT-s-OFDM QPSK	Outer_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.						
NOTE 2: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".						

#### 6.3A.1.6.5 Test requirement

For each component carrier, the minimum EIRP shall not exceed the values specified in Table 6.3A.1.6.5-1 and 6.3A.1.6.5-2.

**Table 6.3A.1.6.5-1: Minimum output power for 7UL CA for power class 1**

Operating band	Channel bandwidth (MHz)	Minimum output power (dBm)	Measurement bandwidth (MHz)
n257, n258, n260, n261	50	4+TBD+TT	47.58
	100	4+TBD+TT	95.16
	200	4+TBD+TT	190.20
	400	4+TBD+TT	380.28

**Table 6.3A.1.6.5-2: Minimum output power for 7UL CA for power class 3**

Operating band	Channel bandwidth (MHz)	Minimum output power (dBm)	Measurement bandwidth (MHz)
n257, n258, n261	50	-13+TT	47.58
	100	-13+2.4+TT	95.16
	200	-13+5.4+TT	190.20
	400	-13+8.4+TT	380.28
n260	50	-13+4.5+TT	47.58
	100	-13+7.5+TT	95.16
	200	-13+10.5+TT	190.20
	400	-13+13.5+TT	380.28
NOTE 1: n260 is not applied for power class 2.			

**Table 6.3A.1.6.5-2a: Minimum output power for 7UL CA for power class 2 and 4**

Operating band	Channel bandwidth (MHz)	Minimum output power (dBm)	Measurement bandwidth (MHz)
n257, n258, n260, n261	50	-13+TBD+TT	47.58
	100	-13+TBD+TT	95.16
	200	-13+TBD+TT	190.20
	400	-13+TBD+TT	380.28
NOTE 1: n260 is not applied for power class 2.			

**Table 6.3A.1.6.5-3: Test Tolerance for Minimum output power for 7UL CA for Power class 1, 2, 4**

Test Metric	FR2a	FR2b
Max device size ≤ 30 cm	FFS	FFS

**Table 6.3A.1.6.5-4: Test Tolerance for Minimum output power for 7UL CA for Power class 3**

Test Metric	FR2a	FR2b
Max device size ≤ 30 cm	Same as in table 6.3.1.5-2	Same as in table 6.3.1.5-2

### 6.3A.1.7 Minimum output power for CA (8UL CA)

Editor's note: The following aspects are either missing or not yet determined:

- Relaxation, Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.
- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 800MHz is FFS as test system complexity might increase.

#### 6.3A.1.7.1 Test purpose

To verify the UE's ability to transmit with a broadband output power below the value specified in the test requirement when the power on each component carrier is set to a minimum value.

#### 6.3A.1.7.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 8UL CA.

#### 6.3A.1.7.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.3A.1.0.

#### 6.3A.1.7.4 Test description

Same as in clause 6.3A.1.1.4 with following exceptions:

- Instead of Table 6.3A.1.1.4.1-1 → use Table 6.3A.1.7.4-1.
- Instead of Table 6.3A.1.1.5-1 and 6.3A.1.1.5-2 → use Table 6.3A.1.7.5-1 and 6.3A.1.7.5-2.

**Table 6.3A.1.7.4-1: Test Configuration Table for 8UL CA**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.				Low and High range		
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.				Lowest aggregated BW of the CA configuration Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1.				Highest		
Test Parameters						
Test ID	CC	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation
1	PCC	Default	Default	-	DFT-s-OFDM QPSK	Outer_Full
	SCC1				DFT-s-OFDM QPSK	Outer_Full
	SCC2				DFT-s-OFDM QPSK	Outer_Full
	SCC3				DFT-s-OFDM	Outer_Full

					QPSK	
	SCC4				DFT-s-OFDM QPSK	Outer_Full
	SCC5				DFT-s-OFDM QPSK	Outer_Full
	SCC6				DFT-s-OFDM QPSK	Outer_Full
	SCC7				DFT-s-OFDM QPSK	Outer_Full
<p>NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.</p> <p>NOTE 2: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".</p>						

6.3A.1.7.5 Test requirement

For each component carrier, the minimum EIRP shall not exceed the values specified in Table 6.3A.1.7.5-1 and 6.3A.1.7.5-2.

**Table 6.3A.1.7.5-1: Minimum output power for 8UL CA for power class 1**

Operating band	Channel bandwidth (MHz)	Minimum output power (dBm)	Measurement bandwidth (MHz)
n257, n258, n260, n261	50	4+TBD+TT	47.58
	100	4+TBD+TT	95.16
	200	4+TBD+TT	190.20
	400	4+TBD+TT	380.28

**Table 6.3A.1.7.5-2: Minimum output power for 8UL CA for power class 3**

Operating band	Channel bandwidth (MHz)	Minimum output power (dBm)	Measurement bandwidth (MHz)
n257, n258, n261	50	-13+TT	47.58
	100	-13+2.4+TT	95.16
	200	-13+5.4+TT	190.20
	400	-13+8.4+TT	380.28
n260	50	-13+4.5+TT	47.58
	100	-13+7.5+TT	95.16
	200	-13+10.5+TT	190.20
	400	-13+13.5+TT	380.28

NOTE 1: n260 is not applied for power class 2.

**Table 6.3A.1.7.5-2a: Minimum output power for 8UL CA for power class 2 and 4**

Operating band	Channel bandwidth (MHz)	Minimum output power (dBm)	Measurement bandwidth (MHz)
n257, n258, n260, n261	50	-13+TBD+TT	47.58
	100	-13+TBD+TT	95.16
	200	-13+TBD+TT	190.20
	400	-13+TBD+TT	380.28

NOTE 1: n260 is not applied for power class 2.

**Table 6.3A.1.7.5-3: Test Tolerance for Minimum output power for 8UL CA for Power class 1, 2, 4**

Test Metric	FR2a	FR2b
Max device size ≤ 30 cm	FFS	FFS

**Table 6.3A.1.7.5-4: Test Tolerance for Minimum output power for 8UL CA for Power class 3**

Test Metric	FR2a	FR2b
Max device size ≤ 30 cm	Same as in table 6.3.1.5-2	Same as in table 6.3.1.5-2

## 6.3A.2 Transmit OFF power for CA

### 6.3A.2.0 Minimum conformance requirements

For intra-band contiguous carrier aggregation, the transmit OFF power is defined as the TRP in the channel bandwidth per component carrier when the transmitter is OFF. The transmitter is considered OFF when the UE is not allowed to transmit or during periods when the UE is not transmitting a sub-frame. During DTX and measurements gaps, the transmitter is not considered OFF.

The transmit OFF power shall not exceed the values specified in Table 6.3A.2.0-1 for each operating band supported.

**Table 6.3A.2.0-1: Transmit OFF power for CA**

Operating band	Channel bandwidth / Transmit OFF power (dBm) / measurement bandwidth			
	50 MHz	100 MHz	200 MHz	400 MHz
n257, n258, n260, n261	-35	-35	-35	-35
	47.58 MHz	95.16 MHz	190.20 MHz	380.28 MHz

The normative reference for this requirement is TS 38.101-2 [3] clause 6.3A.2.

6.3A.2.1 Void

6.3A.2.2 Void

6.3A.2.3 Void

## 6.3A.3 Transmit ON/OFF time mask for CA

### 6.3A.3.0 Minimum conformance requirements

For intra-band contiguous carrier aggregation, the general output power ON/OFF time mask specified in subclause 6.3.3.2 is applicable for each component carrier during the ON power period and the transient periods. The OFF period as specified in subclause 6.3.3.2 shall only be applicable for each component carrier when all the component carriers are OFF.

The normative reference for this requirement is TS 38.101-2 [3] clause 6.3A.3.

6.3A.3.1 General ON/OFF time mask for CA

6.3A.3.1.1 General ON/OFF time mask for CA (2UL CA)

**Editor's Note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- Measurement Uncertainty and Test Tolerances are FFS.
- Test requirement of ON power is FFS.
- Testability of OFF power needs further study.
- The method of setting UE transmitted power is FFS.



- TP analysis is FFS
- Applicability of Beam peak of single UL is FFS.
- The UPLF test mode is applicable to UEs Release 16 and forward. This test case is incomplete for Release 15 until UE PHR method is used to prevent SCell drop.

#### 6.3A.3.1.1.1 Test purpose

To verify that the general ON/OFF time mask for CA meets the requirements given in 6.3A.3.1.1.5. Transmission of the wrong power increases interference to other channels, or increases transmission errors in the uplink channel.

#### 6.3A.3.1.1.2 Test applicability

The requirements of this test apply to all types of NR UE release 16 and forward supporting 2UL CA.

#### 6.3A.3.1.1.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.3A.3.0.

#### 6.3A.3.1.1.4 Test description

##### 6.3A.3.1.1.4.1 Initial conditions

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, and CC combinations based on NR operating bands specified in clause 5.5A. All of these configurations shall be tested with applicable test parameters for each CA configuration and subcarrier spacing, are shown in Table 6.3A.3.1.1.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.3A.3.1.1.4.1-1: Intra-band Contiguous UL CA Test Configuration Table**

Default Conditions							
Test Environment as specified in TS 38.508-1 [10] subclause 4.1					FFS		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes					FFS		
Test CC Combination setting (N <sub>RB_agg</sub> ) as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE					FFS		
Test SCS as specified in Table 5.3.5-1					FFS		
Test Parameters							
Test ID	CC	Band	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation
Default Test Settings for a CA_XG, CA_nXO Configuration (Cumulative aggregated BWchannel < 400MHz)							
1							

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement channels are set according to Table 6.3A.3.1.1.4.1-1.
5. Propagation conditions are set according to Annex B.0

6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.3A.3.1.1.4.3.

#### 6.3A.3.1.1.4.2 Test procedure

1. Configure SCC according to Annex C.0, C.1, C.2 and Annex C.3.0 for all downlink physical channels
2. The SS shall configure SCC as per TS 38.508-1 [10] subclause 5.5.1 Procedure to configure SCC(s) for NR RF CA testing. Message contents are defined in subclause 6.3A.3.1.1.4.3.
3. Apply the test step based on the 5G NR UE Release:
  - 3a. For Release 16 and forward 5G NR UEs: SS applies a backoff on the PCell power by activating the UE Power Limit Function (UPLF). The ACTIVATE POWER LIMIT REQUEST procedure is performed as specified in TS 38.508-1 [10] clause 4.9.32 using condition 'NR FR2 2CA'. UE shall transmit ACTIVATE POWER LIMIT RESPONSE to SS. Go to step 4.
  - 3b. For Release 15 5G NR UEs: Test Procedure updates to keep SCell active are FFS. Skip remaining steps.
4. SS activates SCC by sending the activation MAC CE (Refer TS 38.321 [28], clauses 5.9, 6.1.3.10). Wait for at least 2 seconds (Refer TS 38.133[25], clause 9.3).
5. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.3A.3.1.1.4.1-1. Since the UL has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC. The UL assignment is such that the UE transmits on slot 37 for 60kHz SCS and on slot 74 for 120kHz SCS.
6. Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
7. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
8. For UE transmission OFF power, measure UE EIRP in the Tx beam peak direction for each component carrier in the channel bandwidth of the radio access mode according to the test configuration, which shall meet the requirements described in Table 6.3A.3.1.1.5-1. EIRP test procedure is defined in Annex K. The period of the measurement shall be the slot prior to the PUSCH transmission, excluding a transient period of 5  $\mu$ s in the end of the slot and any DL periods. EIRP is calculated considering both polarizations, theta and phi.
9. For UE transmission ON power, measure UE EIRP in the Tx beam peak direction for each component carrier in the channel bandwidth of the radio access mode according to the test configuration, which shall meet the requirements described in Table 6.3A.3.1.1.5-2. EIRP test procedure is defined in Annex K. The period of the measurement shall be one slot with PUSCH transmission. EIRP is calculated considering both polarizations, theta and phi. For TDD slots with transient periods are not under test.
10. For UE transmission OFF power, measure UE EIRP in the Tx beam peak direction for each component carrier in the channel bandwidth of the radio access mode according to the test configuration, which shall meet the requirements described in Table 6.3A.3.1.1.5-1. EIRP test procedure is defined in Annex K. The period of the measurement shall be the slot following the PUSCH transmission, excluding a transient period of 5  $\mu$ s at the beginning of the slot and any DL periods. EIRP is calculated considering both polarizations, theta and phi.
11. SS deactivates the UE Power Limit Function (UPLF) by performing the DEACTIVATE POWER LIMIT REQUEST procedure as specified in TS 38.508-1 [10] clause 4.9.33.
12. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

NOTE 2: When switching to DFT-s-OFDM waveform, as specified in Table 6.3A.3.1.1.4.1-1, send an NR RRCReconfiguration message according to TS 38.508-1 [10] clause 4.6.3 Table 4.6.3-118 PUSCH-Config with TRANSFORM\_PRECODER\_ENABLED condition.

## 6.3A.3.1.1.4.3 Message contents

Message contents are according to TS 38.508-1 [10] clause 4.6 with the following exceptions:

**Table 6.3A.3.1.1.4.3-1: PUSCH-ConfigCommon**

Derivation Path: TS 38.508-1[10], Table 4.6.3-119			
Information Element	Value/remark	Comment	Condition
PUSCH-ConfigCommon ::= SEQUENCE {			
p0-NominalWithGrant	-106		
}			

## 6.3A.3.1.1.5 Test requirements

The requirement for the power measured in steps 7, 8 and 9 of the test procedure shall not exceed the values specified in Table 6.3A.3.1.1.5-1 and Table 6.3A.3.1.1.5-2.

**Table 6.3A.3.1.1.5-1: Test requirement of OFF power of General ON/OFF time mask for 2UL CA**

	Channel bandwidth / minimum output power / measurement bandwidth			
	50 MHz	100 MHz	200 MHz	400 MHz
Transmit OFF power	≤ -30+TT dBm			
Transmission OFF Measurement bandwidth	47.58 MHz	95.16 MHz	190.20 MHz	380.28 MHz

**Table 6.3A.3.1.1.5-2: Test requirement of ON power of General ON/OFF time mask for 2UL CA**

	SCS [kHz]	Channel bandwidth / minimum output power / measurement bandwidth			
		50 MHz	100 MHz	200 MHz	400 MHz
Expected Transmission ON	60	FFS	FFS	FFS	FFS
Measured power for CP-OFDM	120	FFS	FFS	FFS	FFS
Expected Transmission ON	60	FFS	FFS	FFS	FFS
Measured power for DFT-s-OFDM	120	FFS	FFS	FFS	FFS

**Table 6.3A.3.1.1.5-3: Test Tolerance for OFF power**

FFS

**Table 6.3A.3.1.1.5-4: Test Tolerance for ON power**

FFS

## 6.3A.3.1.2 General ON/OFF time mask for CA (3UL CA)

FFS

## 6.3A.3.1.3 General ON/OFF time mask for CA (4UL CA)

FFS

## 6.3A.3.1.4 General ON/OFF time mask for CA (5UL CA)

FFS

#### 6.3A.3.1.5 General ON/OFF time mask for CA (6UL CA)

FFS

#### 6.3A.3.1.6 General ON/OFF time mask for CA (7UL CA)

FFS

#### 6.3A.3.1.7 General ON/OFF time mask for CA (8UL CA)

FFS

### 6.3A.4 Power control for CA

#### 6.3A.4.1 General

The requirements in this section apply to a UE when it has at least one of UL or DL configured for CA operation. The requirements on power control accuracy in CA operation apply under normal conditions and are defined as a directional requirement. The requirements are verified in beam locked mode on beam peak direction. The requirements apply for one single PUCCH, PUSCH or SRS transmission of contiguous PRB allocation per configured UL CC with power setting in accordance with Clause 7.1 of TS 38.213 [22].

#### 6.3A.4.2 Absolute power tolerance for CA

##### 6.3A.4.2.0 Minimum conformance requirements

The absolute power tolerance is the ability of the UE transmitter to set its initial output power to a specific value for the first sub-frame at the start of a contiguous transmission or non-contiguous transmission with a transmission gap on each active component carriers larger than 20 ms. For SRS switching, the absolute power tolerance is the ability of the UE transmitter to set its initial output power to a specific value for the first sub-frame at the start of a contiguous transmission or non-contiguous transmission with a transmission gap on component carriers (to which SRS switching occurs) larger than 20 ms. The requirement can be tested by time aligning any transmission gaps on the component carriers. For intra-band contiguous CA, the absolute power control tolerance per configured UL CC is given in Tables 6.3.4.2.3-1 and 6.3.4.2.3-2.

##### 6.3A.4.2.1 Absolute power tolerance for CA (2UL CA)

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- Measurement Uncertainty and Test Tolerances are FFS.
- TP analysis is FFS.
- UE transmitted power for PC 1, 2 and 4 are FFS
- The UPLF test mode is applicable to UEs Release 16 and forward. This test case is incomplete for Release 15 until UE PHR method is used to prevent SCell drop.

###### 6.3A.4.2.1.1 Test purpose

To verify the UE's ability to transmit with a broadband output power below the value specified in the test requirement when the power is set to a minimum value.

To verify the ability of the UE transmitter to set its initial output power to a specific value at the start of a contiguous transmission or non-contiguous transmission with a long transmission gap, i.e. transmission gap is larger than 20 ms.

###### 6.3A.4.2.1.2 Test applicability

This test case applies to all types of NR UE release 16 and forward that supports FR2 2UL CA.

## 6.3A.4.2.1.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.3A.4.2.0.

## 6.3A.4.2.1.4 Test description

## 6.3A.4.2.1.4.1 Initial condition

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, test channel bandwidth and subcarrier spacing based on NR CA configurations based on NR operating bands specified in clause 5.5A. All of these configurations shall be tested with applicable test parameters for each CA combination and subcarrier spacing, are shown in Table 6.3A.4.2.1.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.3A.4.2.1.4.1-1: Test Configuration Table**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.				Low and High range		
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.				Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1.				Highest		
Test Parameters						
Test ID	CC	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation (Note 1)
1	PCC	Default	Default	-	DFT-s-OFDM QPSK	Outer_Full
	SCC				DFT-s-OFDM QPSK	Outer_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.						
NOTE 2: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: " <i>The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier</i> ".						

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] clause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement Channel is set according to Table 6.3A.4.2.1.4.1-1.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in State RRC\_CONNECTED with generic procedure parameters Connectivity NR, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.3A.4.2.1.4.3.

## 6.3A.4.2.1.4.2 Test procedure

1. Configure SCC according to Annex C.0, C.1, C.2, and C.3 for all downlink physical channels.
2. The SS shall configure SCC as per TS 38.508-1 [10] clause 5.5.1. Message contents are defined in clause 6.3A.4.2.1.4.3.

3. Apply the test step based on the 5G NR UE Release:
  - 3a. For Release 16 and forward 5G NR UEs: SS applies a backoff on the PCell power by activating the UE Power Limit Function (UPLF). The ACTIVATE POWER LIMIT REQUEST procedure is performed as specified in TS 38.508-1 [10] clause 4.9.32 using condition ‘NR FR2 2CA’. UE shall transmit ACTIVATE POWER LIMIT RESPONSE to SS. Go to step 4.
  - 3b. For Release 15 5G NR UEs: Test Procedure updates to keep SCell active are FFS. Skip remaining steps.
4. SS activates SCC by sending the activation MAC CE (Refer TS 38.321 [28], clauses 5.9, 6.1.3.10). Wait for at least 2 seconds (Refer TS 38.133[25], clause 9.2).
5. SS sends uplink scheduling information via PDCCH DCI format 0\_1 with TPC command 0dB for C\_RNTI to schedule the UL RMC according to Table 6.3A.4.2.1.4.1-1 on PCC and SCC(s). Since the UE has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC.
6. Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
7. Configure the UE transmitted output power to test point 1 in section 6.3A.4.2.1.4.3. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
8. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
9. Measure UE EIRP of the first subframe of each component carrier in the Tx beam peak direction in the measurement bandwidth specified in Table 6.3A.4.2.1.5-1 through Table 6.3A.4.2.1.5-3 for the specific channel bandwidth under test. EIRP test procedure is defined in Annex K. The measuring duration is one active uplink subframe. EIRP is calculated considering both polarizations, theta and phi. For TDD slots with transient periods are not under test.
10. SS deactivates the UE Power Limit Function (UPLF) by performing the DEACTIVATE POWER LIMIT REQUEST procedure as specified in TS 38.508-1 [10] clause 4.9.33.
11. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.
12. Repeat test steps 1~11 for measurement for test point 2~3. The timing of the execution between each test point shall be larger than 20ms.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

6.3A.4.2.1.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with TRANSFORM\_PRECODER\_ENABLED condition in Table 4.6.3-118 PUSCH-Config and with following exceptions:

**Table 6.3A.4.2.1.4.3-1: PUSCH-ConfigCommon (Test point 1) for power class 3**

Derivation Path: TS 38.508-1 [10], Table 4.6.3-119			
Information Element	Value/remark	Comment	Condition
PUSCH-ConfigCommon ::= SEQUENCE {			
p0-NominalWithGrant	-116		50MHz
	-120		100MHz
	-122		200MHz
	-126		400MHz
}			

**Table 6.3A.4.2.1.4.3-2: PUSCH-ConfigCommon (Test point 2) for power class 3**

Derivation Path: TS 38.508-1 [10], Table 4. 6.3-119			
Information Element	Value/remark	Comment	Condition
PUSCH-ConfigCommon ::= SEQUENCE {			
p0-NominalWithGrant	-112		50MHz

	-116		100MHz
	-118		200MHz
	-122		400MHz
}			

**Table 6.3A.4.2.1.4.3-3: PUSCH-ConfigCommon (Test point 3) for power class 3**

Derivation Path: TS 38.508-1 [10], Table 4.6.3-119			
Information Element	Value/remark	Comment	Condition
PUSCH-ConfigCommon ::= SEQUENCE {			
p0-NominalWithGrant	-102		50MHz
	-106		100MHz
	-108		200MHz
	-112		400MHz
}			

**Table 6.3A.4.2.1.4.3-5: ServingCellConfigCommon**

Derivation Path: 38.508-1[5], Table 4.6.3-168			
Information Element	Value/remark	Comment	Condition
ServingCellConfigCommon ::= SEQUENCE {			
ss-PBCH-BlockPower	4		SCS_120kHz
	7		SCS_240kHz
}			

Condition	Explanation
SCS_120kHz	SCS=120kHz for SS/PBCH block
SCS_240kHz	SCS=240kHz for SS/PBCH block

**Table 6.3A.4.2.1.4.3-6: PUSCH-PowerControl**

Derivation Path: TS 38.508-1 [10], Table 4.6.3-120			
Information Element	Value/remark	Comment	Condition
PUSCH-PowerControl ::= SEQUENCE {			
tpc-Accumulation	disabled		
p0-AlphaSets SEQUENCE (SIZE (1..maxNrofP0-PUSCH-AlphaSets)) OF SEQUENCE {	1 entry		
P0-PUSCH-AlphaSet[1] SEQUENCE {			
alpha	alpha1		
}			
}			
}			

**6.3A.4.2.1.5 Test requirement**

The measured EIRP in step 8 and 10 shall not to exceed the values specified in Table 6.3A.4.2.1.5-1 through 6.3A.4.2.1.5-3.

**Table 6.3A.4.2.1.5-1: Test Requirements of Absolute power tolerance (Test point 1) for power class 3**

	SCS	Channel bandwidth / expected output power (dBm)			
		50 MHz	100 MHz	200 MHz	400 MHz
Expected Measured power	60kHz	8.1	7.1	8.1	N/A
	120kHz	8.1	7.1	8.1	7.1
Power tolerance		± (14+TT) dB			
Note 1:	The lower power limit shall not exceed the minimum output power requirements defined in sub-clause 6.3A.1, and the higher power limit shall not exceed the Max EIRP defined in sub-clause 6.2A.1.				
Note 2:	TT for each frequency and channel bandwidth is specified in Table 6.3A.4.2.1.5-4.				

**Table 6.3A.4.2.1.5-2: Test Requirements of Absolute power tolerance (Test point 2) for power class 3**

	SCS	Channel bandwidth / expected output power (dBm)			
		50 MHz	100 MHz	200 MHz	400 MHz
Expected Measured power	60kHz	12.1	11.1	12.1	N/A
	120kHz	12.1	11.1	12.1	11.1
Power tolerance		$\pm (12+TT)$ dB			
Note 1: The lower power limit shall not exceed the minimum output power requirements defined in sub-clause 6.3A.1, and the higher power limit shall not exceed the Max EIRP defined in sub-clause 6.2A.1.					
Note 2: TT for each frequency and channel bandwidth is specified in Table 6.3A.4.2.1.5-5.					

**Table 6.3A.4.2.1.5-3: Test Requirements of Absolute power tolerance (Test point 3) for power class 3**

	SCS	Channel bandwidth / expected output power (dBm)			
		50 MHz	100 MHz	200 MHz	400 MHz
Expected Measured power	60kHz	22.1	21.1	22.1	N/A
	120kHz	22.1	21.1	22.1	21.1
Power tolerance		$\pm (12+TT)$ dB			
Note 1: The lower power limit shall not exceed the minimum output power requirements defined in sub-clause 6.3A.1, and the higher power limit shall not exceed the Max EIRP defined in sub-clause 6.2A.1.					
Note 2: TT for each frequency and channel bandwidth is specified in Table 6.3A.4.2.1.5-5.					

**Table 6.3A.4.2.1.5-4: Test Tolerance (Test point 1) for power class 3**

Test Metric	FR2a	FR2b
IFF (Max device size $\leq$ 30 cm)	[FFS] dB	[FFS] dB

**Table 6.3A.4.2.1.5-5: Test Tolerance (Test point 2 and Test point 3) for power class 3**

Test Metric	FR2a	FR2b
IFF (Quiet Zone size $\leq$ 30 cm)	[FFS] dB	[FFS] dB

### 6.3A.4.2.2 Absolute power tolerance for CA (3UL CA)

Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:

- Measurement Uncertainty and Test Tolerances are FFS.
- TP analysis is FFS.
- UE transmitted power for PC 1, 2 and 4 are FFS

#### 6.3A.4.2.2.1 Test purpose

To verify the UE's ability to transmit with a broadband output power below the value specified in the test requirement when the power is set to a minimum value.

To verify the ability of the UE transmitter to set its initial output power to a specific value at the start of a contiguous transmission or non-contiguous transmission with a long transmission gap, i.e. transmission gap is larger than 20 ms.

#### 6.3A.4.2.2.2 Test applicability

This test case applies to all types of NR UE release 16 and forward that supports FR2 3UL CA.



6.3A.4.2.2.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.3A.4.2.0.

6.3A.4.2.2.4 Test description

Same as in clause 6.3A.4.2.1.4 with the following exceptions:

- Instead of Table 6.3A.4.2.1.4.1-1 → use Table 6.3A.4.2.2.4-1.
- Instead of Table 6.3A.4.2.1.5-1 through 6.3A.4.2.1.5-3 → use Table 6.3A.4.2.2.5-1 and 6.3A.4.2.2.5-3.

**Table 6.3A.4.2.2.4-1: Test Configuration Table**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.				Low and High range		
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.				Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1.				Highest		
Test Parameters						
Test ID	CC	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation (Note 1)
1	PCC	Default	Default	-	DFT-s-OFDM QPSK	Outer_Full
	SCC1				DFT-s-OFDM QPSK	Outer_Full
	SCC2				DFT-s-OFDM QPSK	Outer_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.						
NOTE 2: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".						

6.3A.4.2.2.5 Test requirement

Same as in clause 6.3A.4.2.1.5 with the following exceptions:

- Instead of Table 6.3A.4.2.1.5-1 → use Table 6.3A.4.2.2.5-1.
- Instead of Table 6.3A.4.2.1.5-2 → use Table 6.3A.4.2.2.5-2.
- Instead of Table 6.3A.4.2.1.5-3 → use Table 6.3A.4.2.2.5-3.
- Instead of Table 6.3A.4.2.1.5-4 → use Table 6.3A.4.2.2.5-4.
- Instead of Table 6.3A.4.2.1.5-5 → use Table 6.3A.4.2.2.5-5.

**Table 6.3A.4.2.2.5-1: Test Requirements of Absolute power tolerance (Test point 1)**

	SCS	Channel bandwidth / expected output power (dBm)			
		50 MHz	100 MHz	200 MHz	400 MHz
Expected Measured power	60kHz	8.1	7.1	8.1	N/A
	120kHz	8.1	7.1	8.1	7.1
Power tolerance		± (14+TT) dB			
Note 1: The lower power limit shall not exceed the minimum output power requirements defined in sub-clause 6.3A.1, and the higher power limit shall not exceed the Max EIRP defined in sub-clause 6.2A.1.					
Note 2: TT for each frequency and channel bandwidth is specified in Table 6.3A.4.2.2.5-4.					

**Table 6.3A.4.2.2.5-2: Test Requirements of Absolute power tolerance (Test point 2)**

	SCS	Channel bandwidth / expected output power (dBm)			
		50 MHz	100 MHz	200 MHz	400 MHz
Expected Measured power	60kHz	12.1	11.1	12.1	N/A
	120kHz	12.1	11.1	12.1	11.1
Power tolerance		$\pm (12+TT)$ dB			
Note 1: The lower power limit shall not exceed the minimum output power requirements defined in sub-clause 6.3A.1, and the higher power limit shall not exceed the Max EIRP defined in sub-clause 6.2A.1.					
Note 2: TT for each frequency and channel bandwidth is specified in Table 6.3A.4.2.2.5-5.					

**Table 6.3A.4.2.2.5-3: Test Requirements of Absolute power tolerance (Test point 3)**

	SCS	Channel bandwidth / expected output power (dBm)			
		50 MHz	100 MHz	200 MHz	400 MHz
Expected Measured power	60kHz	22.1	21.1	22.1	N/A
	120kHz	22.1	21.1	22.1	21.1
Power tolerance		$\pm (12+TT)$ dB			
Note 1: The lower power limit shall not exceed the minimum output power requirements defined in sub-clause 6.3A.1, and the higher power limit shall not exceed the Max EIRP defined in sub-clause 6.2A.1.					
Note 2: TT for each frequency and channel bandwidth is specified in Table 6.3A.4.2.2.5-5.					

**Table 6.3A.4.2.2.5-4: Test Tolerance (Test point 1)**

Test Metric	FR2a	FR2b
IFF (Max device size $\leq$ 30 cm)	[FFS] dB	[FFS] dB

**Table 6.3A.4.2.2.5-5: Test Tolerance (Test point 2 and Test point 3)**

Test Metric	FR2a	FR2b
IFF (Max device size $\leq$ 30 cm)	[FFS] dB	[FFS] dB

### 6.3A.4.2.3 Absolute power tolerance for CA (4UL CA)

Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:

- Measurement Uncertainty and Test Tolerances are FFS.
- TP analysis is FFS.
- UE transmitted power for PC 1, 2 and 4 are FFS

#### 6.3A.4.2.3.1 Test purpose

To verify the UE's ability to transmit with a broadband output power below the value specified in the test requirement when the power is set to a minimum value.

To verify the ability of the UE transmitter to set its initial output power to a specific value at the start of a contiguous transmission or non-contiguous transmission with a long transmission gap, i.e. transmission gap is larger than 20 ms.

#### 6.3A.4.2.3.2 Test applicability

This test case applies to all types of NR UE release 16 and forward that supports FR2 4UL CA.

6.3A.4.2.3.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.3A.4.2.0.

6.3A.4.2.3.4 Test description

Same as in clause 6.3A.4.2.1.4 with the following exceptions:

- Instead of Table 6.3A.4.2.1.4.1-1 → use Table 6.3A.4.2.3.4-1.
- Instead of Table 6.3A.4.2.1.5-1 through 6.3A.4.2.1.5-3 → use Table 6.3A.4.2.3.5-1 and 6.3A.4.2.3.5-3.

**Table 6.3A.4.2.3.4-1: Test Configuration Table**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.				Low and High range		
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.				Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1.				Highest		
Test Parameters						
Test ID	CC	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation (Note 1)
1	PCC	Default	Default	-	DFT-s-OFDM QPSK	Outer_Full
	SCC1				DFT-s-OFDM QPSK	Outer_Full
	SCC2				DFT-s-OFDM QPSK	Outer_Full
	SCC3				DFT-s-OFDM QPSK	Outer_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.						
NOTE 2: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".						

6.3A.4.2.3.5 Test requirement

Same as in clause 6.3A.4.2.1.5 with the following exceptions:

- Instead of Table 6.3S.4.2.1.5-1 → use Table 6.3A.4.2.3.5-1.
- Instead of Table 6.3S.4.2.1.5-2 → use Table 6.3A.4.2.3.5-2.
- Instead of Table 6.3S.4.2.1.5-3 → use Table 6.3A.4.2.3.5-3.
- Instead of Table 6.3A.4.2.1.5-4 → use Table 6.3A.4.2.3.5-4.
- Instead of Table 6.3A.4.2.1.5-5 → use Table 6.3A.4.2.3.5-5.

**Table 6.3A.4.2.3.5-1: Test Requirements of Absolute power tolerance (Test point 1)**

	SCS	Channel bandwidth / expected output power (dBm)			
		50 MHz	100 MHz	200 MHz	400 MHz
Expected Measured power	60kHz	8.1	7.1	8.1	N/A
	120kHz	8.1	7.1	8.1	7.1
Power tolerance		± (14+TT) dB			
Note 1: The lower power limit shall not exceed the minimum output power requirements defined in sub-clause 6.3A.1, and the higher power limit shall not exceed the Max EIRP defined in sub-clause 6.2A.1.					

Note 2: TT for each frequency and channel bandwidth is specified in Table 6.3A.4.2.3.5-4.

**Table 6.3A.4.2.3.5-2: Test Requirements of Absolute power tolerance (Test point 2)**

	SCS	Channel bandwidth / expected output power (dBm)			
		50 MHz	100 MHz	200 MHz	400 MHz
Expected Measured power	60kHz	12.1	11.1	12.1	N/A
	120kHz	12.1	11.1	12.1	11.1
Power tolerance		± (12+TT) dB			
Note 1: The lower power limit shall not exceed the minimum output power requirements defined in sub-clause 6.3A.1, and the higher power limit shall not exceed the Max EIRP defined in sub-clause 6.2A.1.					
Note 2: TT for each frequency and channel bandwidth is specified in Table 6.3A.4.2.3.5-5.					

**Table 6.3A.4.2.3.5-3: Test Requirements of Absolute power tolerance (Test point 3)**

	SCS	Channel bandwidth / expected output power (dBm)			
		50 MHz	100 MHz	200 MHz	400 MHz
Expected Measured power	60kHz	22.1	21.1	22.1	N/A
	120kHz	22.1	21.1	22.1	21.1
Power tolerance		± (12+TT) dB			
Note 1: The lower power limit shall not exceed the minimum output power requirements defined in sub-clause 6.3A.1, and the higher power limit shall not exceed the Max EIRP defined in sub-clause 6.2A.1.					
Note 2: TT for each frequency and channel bandwidth is specified in Table 6.3A.4.2.3.5-5.					

**Table 6.3A.4.2.3.5-4: Test Tolerance (Test point 1)**

Test Metric	FR2a	FR2b
IFF (Max device size ≤ 30 cm)	[FFS] dB	[FFS] dB

**Table 6.3A.4.2.3.5-5: Test Tolerance (Test point 2 and Test point 3)**

Test Metric	FR2a	FR2b
IFF (Max device size ≤ 30 cm)	[FFS] dB	[FFS] dB

**6.3A.4.2.4 Absolute power tolerance for CA (5UL CA)**

Editor’s note: This clause is incomplete. The following aspects are either missing or not yet determined:

- Measurement Uncertainty and Test Tolerances are FFS.
- TP analysis is FFS.
- UE transmitted power for PC 1, 2 and 4 are FFS

**6.3A.4.2.4.1 Test purpose**

To verify the UE's ability to transmit with a broadband output power below the value specified in the test requirement when the power is set to a minimum value.

To verify the ability of the UE transmitter to set its initial output power to a specific value at the start of a contiguous transmission or non-contiguous transmission with a long transmission gap, i.e. transmission gap is larger than 20 ms.

6.3A.4.2.4.2 Test applicability

This test case applies to all types of NR UE release 16 and forward that supports FR2 5UL CA.

6.3A.4.2.4.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.3A.4.2.0.

6.3A.4.2.4.4 Test description

Same as in clause 6.3A.4.2.1.4 with the following exceptions:

- Instead of Table 6.3A.4.2.1.4.1-1 → use Table 6.3A.4.2.4.4-1.
- Instead of Table 6.3A.4.2.1.5-1 through 6.3A.4.2.1.5-3 → use Table 6.3A.4.2.4.5-1 and 6.3A.4.2.4.5-3.

**Table 6.3A.4.2.4.4-1: Test Configuration Table**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.				Low and High range		
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.				Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1.				Highest		
Test Parameters						
Test ID	CC	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation (Note 1)
1	PCC	Default	Default	-	DFT-s-OFDM QPSK	Outer_Full
	SCC1				DFT-s-OFDM QPSK	Outer_Full
	SCC2				DFT-s-OFDM QPSK	Outer_Full
	SCC3				DFT-s-OFDM QPSK	Outer_Full
	SCC4				DFT-s-OFDM QPSK	Outer_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.						
NOTE 2: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".						

6.3A.4.2.4.5 Test requirement

Same as in clause 6.3A.4.2.1.5 with the following exceptions:

- Instead of Table 6.3A.4.2.1.5-1 → use Table 6.3A.4.2.4.5-1.
- Instead of Table 6.3A.4.2.1.5-2 → use Table 6.3A.4.2.4.5-2.
- Instead of Table 6.3A.4.2.1.5-3 → use Table 6.3A.4.2.4.5-3.
- Instead of Table 6.3A.4.2.1.5-4 → use Table 6.3A.4.2.4.5-4.
- Instead of Table 6.3A.4.2.1.5-5 → use Table 6.3A.4.2.4.5-5.

**Table 6.3A.4.2.4.5-1: Test Requirements of Absolute power tolerance (Test point 1)**

	<b>SCS</b>	<b>Channel bandwidth / expected output power (dBm)</b>
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		50 MHz	100 MHz	200 MHz	400 MHz
Expected Measured power	60kHz	8.1	7.1	8.1	N/A
	120kHz	8.1	7.1	8.1	7.1
Power tolerance		± (14+TT) dB			
Note 1: The lower power limit shall not exceed the minimum output power requirements defined in sub-clause 6.3A.1, and the higher power limit shall not exceed the Max EIRP defined in sub-clause 6.2A.1.					
Note 2: TT for each frequency and channel bandwidth is specified in Table 6.3A.4.2.4.5-4.					

**Table 6.3A.4.2.4.5-2: Test Requirements of Absolute power tolerance (Test point 2)**

		SCS	Channel bandwidth / expected output power (dBm)			
			50 MHz	100 MHz	200 MHz	400 MHz
Expected Measured power	60kHz		12.1	11.1	12.1	N/A
	120kHz		12.1	11.1	12.1	11.1
Power tolerance		± (12+TT) dB				
Note 1: The lower power limit shall not exceed the minimum output power requirements defined in sub-clause 6.3A.1, and the higher power limit shall not exceed the Max EIRP defined in sub-clause 6.2A.1.						
Note 2: TT for each frequency and channel bandwidth is specified in Table 6.3A.4.2.4.5-5.						

**Table 6.3A.4.2.4.5-3: Test Requirements of Absolute power tolerance (Test point 3)**

		SCS	Channel bandwidth / expected output power (dBm)			
			50 MHz	100 MHz	200 MHz	400 MHz
Expected Measured power	60kHz		22.1	21.1	22.1	N/A
	120kHz		22.1	21.1	22.1	21.1
Power tolerance		± (12+TT) dB				
Note 1: The lower power limit shall not exceed the minimum output power requirements defined in sub-clause 6.3A.1, and the higher power limit shall not exceed the Max EIRP defined in sub-clause 6.2A.1.						
Note 2: TT for each frequency and channel bandwidth is specified in Table 6.3A.4.2.4.5-5.						

**Table 6.3A.4.2.4.5-4: Test Tolerance (Test point 1)**

Test Metric	FR2a	FR2b
IFF (Max device size ≤ 30 cm)	[FFS] dB	[FFS] dB

**Table 6.3A.4.2.4.5-5: Test Tolerance (Test point 2 and Test point 3)**

Test Metric	FR2a	FR2b
IFF (Max device size ≤ 30 cm)	[FFS] dB	[FFS] dB

6.3A.4.2.5 Absolute power tolerance for CA (6UL CA)

Editor’s note: This clause is incomplete. The following aspects are either missing or not yet determined:

- Measurement Uncertainty and Test Tolerances are FFS.
- TP analysis is FFS.
- UE transmitted power for PC 1, 2 and 4 are FFS

6.3A.4.2.5.1 Test purpose

To verify the UE's ability to transmit with a broadband output power below the value specified in the test requirement when the power is set to a minimum value.

To verify the ability of the UE transmitter to set its initial output power to a specific value at the start of a contiguous transmission or non-contiguous transmission with a long transmission gap, i.e. transmission gap is larger than 20 ms.

6.3A.4.2.5.2 Test applicability

This test case applies to all types of NR UE release 16 and forward that supports FR2 6UL CA.

6.3A.4.2.5.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.3A.4.2.0.

6.3A.4.2.5.4 Test description

Same as in clause 6.3A.4.2.1.4 with the following exceptions:

- Instead of Table 6.3A.4.2.1.4.1-1 → use Table 6.3A.4.2.5.4-1.
- Instead of Table 6.3A.4.2.1.5-1 through 6.3A.4.2.1.5-3 → use Table 6.3A.4.2.5.5-1 and 6.3A.4.2.5.5-3.

**Table 6.3A.4.2.5.4-1: Test Configuration Table**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.				Low and High range		
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.				Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1.				Highest		
Test Parameters						
Test ID	CC	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation (Note 1)
1	PCC	Default	Default	-	DFT-s-OFDM QPSK	Outer_Full
	SCC1				DFT-s-OFDM QPSK	Outer_Full
	SCC2				DFT-s-OFDM QPSK	Outer_Full
	SCC3				DFT-s-OFDM QPSK	Outer_Full
	SCC4				DFT-s-OFDM QPSK	Outer_Full
	SCC5				DFT-s-OFDM QPSK	Outer_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.						
NOTE 2: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".						

6.3A.4.2.5.5 Test requirement

Same as in clause 6.3A.4.2.1.5 with the following exceptions:

- Instead of Table 6.3A.4.2.1.5-1 → use Table 6.3A.4.2.5.5-1.
- Instead of Table 6.3A.4.2.1.5-2 → use Table 6.3A.4.2.5.5-2.

- Instead of Table 6.3A.4.2.1.5-3 → use Table 6.3A.4.2.5.5-3.
- Instead of Table 6.3A.4.2.1.5-4 → use Table 6.3A.4.2.5.5-4.
- Instead of Table 6.3A.4.2.1.5-5 → use Table 6.3A.4.2.5.5-5.

**Table 6.3A.4.2.5.5-1: Test Requirements of Absolute power tolerance (Test point 1)**

	SCS	Channel bandwidth / expected output power (dBm)			
		50 MHz	100 MHz	200 MHz	400 MHz
Expected Measured power	60kHz	8.1	7.1	8.1	N/A
	120kHz	8.1	7.1	8.1	7.1
Power tolerance		± (14+TT) dB			
Note 1: The lower power limit shall not exceed the minimum output power requirements defined in sub-clause 6.3A.1, and the higher power limit shall not exceed the Max EIRP defined in sub-clause 6.2A.1.					
Note 2: TT for each frequency and channel bandwidth is specified in Table 6.3A.4.2.5.5-4.					

**Table 6.3A.4.2.5.5-2: Test Requirements of Absolute power tolerance (Test point 2)**

	SCS	Channel bandwidth / expected output power (dBm)			
		50 MHz	100 MHz	200 MHz	400 MHz
Expected Measured power	60kHz	12.1	11.1	12.1	N/A
	120kHz	12.1	11.1	12.1	11.1
Power tolerance		± (12+TT) dB			
Note 1: The lower power limit shall not exceed the minimum output power requirements defined in sub-clause 6.3A.1, and the higher power limit shall not exceed the Max EIRP defined in sub-clause 6.2A.1.					
Note 2: TT for each frequency and channel bandwidth is specified in Table 6.3A.4.2.5.5-5.					

**Table 6.3A.4.2.5.5-3: Test Requirements of Absolute power tolerance (Test point 3)**

	SCS	Channel bandwidth / expected output power (dBm)			
		50 MHz	100 MHz	200 MHz	400 MHz
Expected Measured power	60kHz	22.1	21.1	22.1	N/A
	120kHz	22.1	21.1	22.1	21.1
Power tolerance		± (12+TT) dB			
Note 1: The lower power limit shall not exceed the minimum output power requirements defined in sub-clause 6.3A.1, and the higher power limit shall not exceed the Max EIRP defined in sub-clause 6.2A.1.					
Note 2: TT for each frequency and channel bandwidth is specified in Table 6.3A.4.2.5.5-5.					

**Table 6.3A.4.2.5.5-4: Test Tolerance (Test point 1 and Test point 2)**

Test Metric	FR2a	FR2b
IFF (Max device size ≤ 30 cm)	[FFS] dB	[FFS] dB

**Table 6.3A.4.2.5.5-5: Test Tolerance (Test point 2 and Test point 3)**

Test Metric	FR2a	FR2b
IFF (Max device size ≤ 30 cm)	[FFS] dB	[FFS] dB

6.3A.4.2.6 Absolute power tolerance for CA (7UL CA)

Editor’s note: This clause is incomplete. The following aspects are either missing or not yet determined:



- Measurement Uncertainty and Test Tolerances are FFS.
- TP analysis is FFS.
- UE transmitted power for PC 1, 2 and 4 are FFS

6.3A.4.2.6.1 Test purpose

To verify the UE's ability to transmit with a broadband output power below the value specified in the test requirement when the power is set to a minimum value.

To verify the ability of the UE transmitter to set its initial output power to a specific value at the start of a contiguous transmission or non-contiguous transmission with a long transmission gap, i.e. transmission gap is larger than 20 ms.

6.3A.4.2.6.2 Test applicability

This test case applies to all types of NR UE release 16 and forward that supports FR2 7UL CA.

6.3A.4.2.6.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.3A.4.2.0.

6.3A.4.2.6.4 Test description

Same as in clause 6.3A.4.2.1.4 with the following exceptions:

- Instead of Table 6.3A.4.2.1.4.1-1 → use Table 6.3A.4.2.6.4-1.
- Instead of Table 6.3A.4.2.1.5-1 through 6.3A.4.2.1.5-3 → use Table 6.3A.4.2.6.5-1 and 6.3A.4.2.6.5-3.

**Table 6.3A.4.2.6.4-1: Test Configuration Table**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.				Low and High range		
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.				Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1.				Highest		
Test Parameters						
Test ID	CC	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation (Note 1)
1	PCC	Default	Default	-	DFT-s-OFDM QPSK	Outer_Full
	SCC1				DFT-s-OFDM QPSK	Outer_Full
	SCC2				DFT-s-OFDM QPSK	Outer_Full
	SCC3				DFT-s-OFDM QPSK	Outer_Full
	SCC4				DFT-s-OFDM QPSK	Outer_Full
	SCC5				DFT-s-OFDM QPSK	Outer_Full
	SCC6				DFT-s-OFDM QPSK	Outer_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.						
NOTE 2: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".						

6.3A.4.2.6.5 Test requirement

Same as in clause 6.3A.4.2.1.5 with the following exceptions:

- Instead of Table 6.3A.4.2.1.5-1 → use Table 6.3A.4.2.6.5-1.
- Instead of Table 6.3A.4.2.1.5-2 → use Table 6.3A.4.2.6.5-2.
- Instead of Table 6.3A.4.2.1.5-3 → use Table 6.3A.4.2.6.5-3.
- Instead of Table 6.3A.4.2.1.5-4 → use Table 6.3A.4.2.6.5-4.
- Instead of Table 6.3A.4.2.1.5-5 → use Table 6.3A.4.2.6.5-5.

**Table 6.3A.4.2.6.5-1: Test Requirements of Absolute power tolerance (Test point 1)**

	SCS	Channel bandwidth / expected output power (dBm)			
		50 MHz	100 MHz	200 MHz	400 MHz
Expected Measured power	60kHz	7.1	8.1	7.1	N/A
	120kHz	7.1	8.1	7.1	8.1
Power tolerance		± (14+TT) dB			
Note 1: The lower power limit shall not exceed the minimum output power requirements defined in sub-clause 6.3A.1, and the higher power limit shall not exceed the Max EIRP defined in sub-clause 6.2A.1.					
Note 2: TT for each frequency and channel bandwidth is specified in Table 6.3A.4.2.6.5-4.					

**Table 6.3A.4.2.6.5-2: Test Requirements of Absolute power tolerance (Test point 2)**

	SCS	Channel bandwidth / expected output power (dBm)			
		50 MHz	100 MHz	200 MHz	400 MHz
Expected Measured power	60kHz	12.1	11.1	12.1	N/A
	120kHz	12.1	11.1	12.1	11.1
Power tolerance		± (12+TT) dB			
Note 1: The lower power limit shall not exceed the minimum output power requirements defined in sub-clause 6.3A.1, and the higher power limit shall not exceed the Max EIRP defined in sub-clause 6.2A.1.					
Note 2: TT for each frequency and channel bandwidth is specified in Table 6.3A.4.2.6.5-5.					

**Table 6.3A.4.2.6.5-3: Test Requirements of Absolute power tolerance (Test point 3)**

	SCS	Channel bandwidth / expected output power (dBm)			
		50 MHz	100 MHz	200 MHz	400 MHz
Expected Measured power	60kHz	22.1	21.1	22.1	N/A
	120kHz	22.1	21.1	22.1	21.1
Power tolerance		± (12+TT) dB			
Note 1: The lower power limit shall not exceed the minimum output power requirements defined in sub-clause 6.3A.1, and the higher power limit shall not exceed the Max EIRP defined in sub-clause 6.2A.1.					
Note 2: TT for each frequency and channel bandwidth is specified in Table 6.3A.4.2.6.5-5.					

**Table 6.3A.4.2.6.5-4: Test Tolerance (Test point 1)**

Test Metric	FR2a	FR2b
IFF (Max device size ≤ 30 cm)	[FFS] dB	[FFS] dB

**Table 6.3A.4.2.6.5-5: Test Tolerance (Test point 2 and Test point 3)**

Test Metric	FR2a	FR2b
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IFF (Max device size $\leq$ 30 cm)	[FFS] dB	[FFS] dB
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#### 6.3A.4.2.7 Absolute power tolerance for CA (8UL CA)

Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:

- Measurement Uncertainty and Test Tolerances are FFS.
- TP analysis is FFS.
- UE transmitted power for PC 1, 2 and 4 are FFS

##### 6.3A.4.2.7.1 Test purpose

To verify the UE's ability to transmit with a broadband output power below the value specified in the test requirement when the power is set to a minimum value.

To verify the ability of the UE transmitter to set its initial output power to a specific value at the start of a contiguous transmission or non-contiguous transmission with a long transmission gap, i.e. transmission gap is larger than 20 ms.

##### 6.3A.4.2.7.2 Test applicability

This test case applies to all types of NR UE release 16 and forward that supports FR2 8UL CA.

##### 6.3A.4.2.7.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.3A.4.2.0.

##### 6.3A.4.2.7.4 Test description

Same as in clause 6.3A.4.2.1.4 with the following exceptions:

- Instead of Table 6.3A.4.2.1.4.1-1  $\rightarrow$  use Table 6.3A.4.2.7.4-1.
- Instead of Table 6.3A.4.2.1.5-1 through 6.3A.4.2.1.5-3  $\rightarrow$  use Table 6.3A.4.2.7.5-1 and 6.3A.4.2.7.5-3.

**Table 6.3A.4.2.7.4-1: Test Configuration Table**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.				Low and High range		
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.				Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1.				Highest		
Test Parameters						
Test ID	CC	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation (Note 1)
1	PCC	Default	Default	-	DFT-s-OFDM QPSK	Outer_Full
	SCC1				DFT-s-OFDM QPSK	Outer_Full
	SCC2				DFT-s-OFDM QPSK	Outer_Full
	SCC3				DFT-s-OFDM QPSK	Outer_Full
	SCC4				DFT-s-OFDM QPSK	Outer_Full
	SCC5				DFT-s-OFDM QPSK	Outer_Full
	SCC6				DFT-s-OFDM QPSK	Outer_Full

					QPSK	
	SCC7				DFT-s-OFDM QPSK	Outer_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.						
NOTE 2: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".						

6.3A.4.2.7.5 Test requirement

Same as in clause 6.3A.4.2.1.5 with the following exceptions:

- Instead of Table 6.3A.4.2.1.5-1 → use Table 6.3A.4.2.7.5-1.
- Instead of Table 6.3A.4.2.1.5-2 → use Table 6.3A.4.2.7.5-2.
- Instead of Table 6.3A.4.2.1.5-3 → use Table 6.3A.4.2.7.5-3.
- Instead of Table 6.3A.4.2.1.5-4 → use Table 6.3A.4.2.7.5-4.
- Instead of Table 6.3A.4.2.1.5-5 → use Table 6.3A.4.2.7.5-5.

**Table 6.3A.4.2.7.5-1: Test Requirements of Absolute power tolerance (Test point 1)**

	SCS	Channel bandwidth / expected output power (dBm)			
		50 MHz	100 MHz	200 MHz	400 MHz
Expected Measured power	60kHz	8.1	7.1	8.1	N/A
	120kHz	8.1	7.1	8.1	7.1
Power tolerance		± (14+TT) dB			
Note 1: The lower power limit shall not exceed the minimum output power requirements defined in sub-clause 6.3A.1, and the higher power limit shall not exceed the Max EIRP defined in sub-clause 6.2A.1.					
Note 2: TT for each frequency and channel bandwidth is specified in Table 6.3A.4.2.7.5-4.					

**Table 6.3A.4.2.7.5-2: Test Requirements of Absolute power tolerance (Test point 2)**

	SCS	Channel bandwidth / expected output power (dBm)			
		50 MHz	100 MHz	200 MHz	400 MHz
Expected Measured power	60kHz	12.1	11.1	12.1	N/A
	120kHz	12.1	11.1	12.1	11.1
Power tolerance		± (12+TT) dB			
Note 1: The lower power limit shall not exceed the minimum output power requirements defined in sub-clause 6.3A.1, and the higher power limit shall not exceed the Max EIRP defined in sub-clause 6.2A.1.					
Note 2: TT for each frequency and channel bandwidth is specified in Table 6.3A.4.2.7.5-5.					

**Table 6.3A.4.2.7.5-3: Test Requirements of Absolute power tolerance (Test point 3)**

	SCS	Channel bandwidth / expected output power (dBm)			
		50 MHz	100 MHz	200 MHz	400 MHz
Expected Measured power	60kHz	22.1	21.1	22.1	N/A
	120kHz	22.1	21.1	22.1	21.1
Power tolerance		± (12+TT) dB			
Note 1: The lower power limit shall not exceed the minimum output power requirements defined in sub-clause 6.3A.1, and the higher power limit shall not exceed the Max EIRP defined in sub-clause 6.2A.1.					
Note 2: TT for each frequency and channel bandwidth is specified in Table 6.3A.4.2.7.5-5.					

**Table 6.3A.4.2.7.5-4: Test Tolerance (Test point 1)**

Test Metric	FR2a	FR2b
IFF (Max device size ≤ 30 cm)	[FFS] dB	[FFS] dB

**Table 6.3A.4.2.7.5-5: Test Tolerance (Test point 2 and Test point 3)**

Test Metric	FR2a	FR2b
IFF (Max device size ≤ 30 cm)	[FFS] dB	[FFS] dB

### 6.3A.4.3 Relative power tolerance for CA

#### 6.3A.4.3.0 Minimum conformance requirements

FFS

#### 6.3A.4.3.1 Relative power tolerance for CA (2UL CA)

FFS

#### 6.3A.4.3.2 Relative power tolerance for CA (3UL CA)

FFS

#### 6.3A.4.3.3 Relative power tolerance for CA (4UL CA)

FFS

#### 6.3A.4.3.4 Relative power tolerance for CA (5UL CA)

FFS

#### 6.3A.4.3.5 Relative power tolerance for CA (6UL CA)

FFS

#### 6.3A.4.3.6 Relative power tolerance for CA (7UL CA)

FFS

#### 6.3A.4.3.7 Relative power tolerance for CA (8UL CA)

FFS

### 6.3A.4.4 Aggregate power tolerance for CA

#### 6.3A.4.4.0 Minimum conformance requirements

The aggregate power control tolerance is the ability of the UE transmitter to maintain its power during non-contiguous transmissions within 21 ms in response to 0 dB TPC commands with respect to the first UE transmission and all other power control parameters as specified in TS 38.213 [22] kept constant.

For intra-band contiguous CA, the aggregate power tolerance per CC is given in Tables 6.3.4.4.3-1 and 6.3.4.4.3-2, with simultaneous PUSCH configured. The average PSDs over each assigned CC shall be aligned before the start of the test. The requirement can be tested with the transmission gaps time aligned between component carriers.

### 6.3A.4.4.1 Aggregate power tolerance for CA (2UL CA)

Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:

- Measurement Uncertainty and Test Tolerances are FFS.
- UE transmitted power for PC 1, 2 and 4 are FFS.
- Power window is FFS.
- How to ensure equal PSD between component carriers is FFS.
- The UPLF test mode is applicable to UEs Release 16 and forward. This test case is incomplete for Release 15 until UE PHR method is used to prevent SCell drop.

#### 6.3A.4.4.1.1 Test purpose

To verify the ability of the UE transmitter to maintain its power during non-contiguous transmissions within 21ms in response to 0 dB commands with respect to the first UE transmission and all other power control parameters as specified in TS 38.213 [22] kept constant.

#### 6.3A.4.4.1.2 Test applicability

This test case applies to all types of NR UE release 16 and forward that supports FR2 2UL CA.

#### 6.3A.4.4.1.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.3A.4.4.0.

#### 6.3A.4.4.1.4 Test description

##### 6.3A.4.4.1.4.1 Initial condition

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, test channel bandwidth and subcarrier spacing based on NR CA configurations based on NR operating bands specified in clause 5.5A. All of these configurations shall be tested with applicable test parameters for each CA combination and subcarrier spacing, are shown in Table 6.3A.4.4.1.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annex A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.3A.4.4.1.4.1-1: Test Configuration Table: PUSCH**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.				Mid range		
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.				Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1.				Highest		
Test Parameters						
Test ID	CC	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation (Note 1)
1	PCC	Default	Default	-	DFT-s-OFDM QPSK	Inner_Full
	SCC				DFT-s-OFDM QPSK	Inner_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.						
NOTE 2: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range						

*between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".*

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] clause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement Channel is set according to Table 6.3A.4.4.1.4.1-1.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in State RRC\_CONNECTED with generic procedure parameters Connectivity NR, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.3A.4.4.1.4.3.

#### 6.3A.4.4.1.4.2 Test procedure

The procedure is only to verify PUSCH aggregate power control tolerance. The uplink transmission patterns are described in Figure 6.3.4.4.4.2-1.

1. Configure SCC according to Annex C.0, C.1, C.2, and C.3 for all downlink physical channels.
2. The SS shall configure SCC as per TS 38.508-1 [10] clause 5.5.1. Message contents are defined in clause 6.3A.4.4.1.4.3.
3. Apply the test step based on the 5G NR UE Release:
  - 3a. For Release 16 and forward 5G NR UEs: SS applies a backoff on the PCell power by activating the UE Power Limit Function (UPLF). The ACTIVATE POWER LIMIT REQUEST procedure is performed as specified in TS 38.508-1 [10] clause 4.9.32 using condition 'NR FR2 2CA'. UE shall transmit ACTIVATE POWER LIMIT RESPONSE to SS. Go to step 4.
  - 3b. For Release 15 5G NR UEs: Test Procedure updates to keep SCell active are FFS. Skip remaining steps.
4. SS activates SCC by sending the activation MAC CE (Refer TS 38.321 [28], clause 5.9, 6.1.3.10). Wait for at least 2 seconds (Refer TS 38.133 [25], clause 9.2).
5. Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
6. The SS sends uplink scheduling information via PDCCH DCI format 0\_1 for C\_RNTI to schedule the PUSCH on PCC and SCC according to Table 6.3A.4.4.1.4.1-1. Since the UE has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC. Send uplink power control commands for PUSCH to the UE using 1dB power step size to ensure that the UE output power measured by the test system is within  $P_w$  of the target power level specified in Table 6.3.4.4.4.2-1 according to the power class with power ID = 1.  $P_w$  is the power window according to Table 6.3.4.4.4.2-2 for the carrier frequency  $f$  and the channel bandwidth BW. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
7. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
8. Every 10 sub-frames (10ms) schedule the UE's PUSCH data transmission for 1 sub-frame (1ms) and transmit 0 dB TPC command for PUSCH via the PDCCH to make the UE transmit PUSCH. The uplink transmission patterns are described in Figure 6.3.4.4.4.2-1.
9. Measure the UE EIRP of 3 consecutive PUSCH transmissions on each component carrier in the Tx beam peak direction of in the measurement bandwidth specified in Table 6.3A.1.1.5-1 and Table 6.3A.1.1.5-2 to verify the UE transmitted PUSCH power is maintained within 21ms. EIRP test procedure is defined in Annex K. EIRP is calculated considering both polarizations, theta and phi. For TDD slots with transient periods are not under test.
10. SS deactivates the UE Power Limit Function (UPLF) by performing the DEACTIVATE POWER LIMIT REQUEST procedure as specified in TS 38.508-1 [10] clause 4.9.33.

11. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

12. Repeat test step 4 to 11 for measurement for power ID = 2 in Table 6.3.4.4.4.2-1.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

#### 6.3A.4.4.1.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with TRANSFORM\_PRECODER\_ENABLED condition in Table 4.6.3-118 PUSCH-Config.

#### 6.3A.4.4.1.5 Test requirement

The requirement for the power measurements made in step 8 of the test procedure shall not exceed the values specified in Table 6.3A.4.4.1.5-1 and Table 6.3A.4.4.1.5-2. The power measurement period shall be 1 sub-frame (1ms).

**Table 6.3A.4.4.1.5-1: Power control tolerance ( $P_{\text{int}} \geq P \geq P_{\text{min}}$ )**

TPC command	UL channel	Test requirement measured power
0 dB	PUSCH	Given 3 power measurements in the pattern, the 2 <sup>nd</sup> , and later measurements shall be within $\pm(5.5\text{dB}+\text{TT})$ of the 1 <sup>st</sup> measurement.
Note 1: TT for each duplex, Sub-Carrier Spacing, frequency and channel bandwidth is specified in Table 6.3A.4.4.1.5-3.		

**Table 6.3A.4.4.1.5-2: Power control tolerance ( $P_{\text{max}} \geq P > P_{\text{int}}$ )**

TPC command	UL channel	Test requirement measured power
0 dB	PUSCH	Given 3 power measurements in the pattern, the 2 <sup>nd</sup> , and later measurements shall be within $\pm(3.5\text{dB}+\text{TT})$ of the 1 <sup>st</sup> measurement.
Note 1: TT for each duplex, Sub-Carrier Spacing, frequency and channel bandwidth is specified in Table 6.3A.4.4.1.5-4.		

**Table 6.3A.4.4.1.5-3: Test Tolerance ( $P_{\text{int}} \geq P \geq P_{\text{min}}$ )**

Test Metric	FR2a	FR2b
IFF (Quiet Zone size $\leq 30$ cm)	FFS	FFS

**Table 6.3A.4.4.1.5-4: Test Tolerance ( $P_{\text{max}} \geq P > P_{\text{int}}$ )**

Test Metric	FR2a	FR2b
IFF (Quiet Zone size $\leq 30$ cm)	FFS	FFS

#### 6.3A.4.4.2 Aggregate power tolerance for CA (3UL CA)

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

Measurement Uncertainty and Test Tolerances are FFS.

UE transmitted power for PC 1, 2 and 4 are FFS.

Power window is FFS.

How to ensure equal PSD between component carriers is FFS.



6.3A.4.4.2.1 Test purpose

To verify the ability of the UE transmitter to maintain its power during non-contiguous transmissions within 21ms in response to 0 dB commands with respect to the first UE transmission and all other power control parameters as specified in TS 38.213 [22] kept constant.

6.3A.4.4.2.2 Test applicability

This test case applies to all types of NR UE release 16 and forward that supports FR2 3UL CA.

6.3A.4.4.2.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.3A.4.4.0.

6.3A.4.4.2.4 Test description

Same as in clause 6.3A.4.4.1.4 with the following exceptions:

- Instead of Table 6.3A.4.4.1.4.1-1 → use Table 6.3A.4.4.2.4-1.

**Table 6.3A.4.4.2.4-1: Test Configuration Table: PUSCH**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.				Mid range		
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.				Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1.				Highest		
Test Parameters						
Test ID	CC	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation (Note 1)
1	PCC	Default	Default	-	DFT-s-OFDM QPSK	Inner_Full
	SCC1				DFT-s-OFDM QPSK	Inner_Full
	SCC2				DFT-s-OFDM QPSK	Inner_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.						
NOTE 2: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".						

6.3A.4.4.2.5 Test requirement

The requirement for the power measurements made in step 8 of the test procedure shall not exceed the values specified in Table 6.3A.4.4.2.5-1 and Table 6.3A.4.4.2.5-2. The power measurement period shall be 1 sub-frame (1ms).

**Table 6.3A.4.4.2.5-1: Power control tolerance ( $P_{int} \geq P \geq P_{min}$ )**

TPC command	UL channel	Test requirement measured power
0 dB	PUSCH	Given 3 power measurements in the pattern, the 2 <sup>nd</sup> , and later measurements shall be within $\pm(5.5dB+TT)$ of the 1 <sup>st</sup> measurement.
Note 1: TT for each duplex, Sub-Carrier Spacing, frequency and channel bandwidth is specified in Table 6.3A.4.4.2.5-3.		

**Table 6.3A.4.4.2.5-2: Power control tolerance ( $P_{\max} \geq P > P_{\text{int}}$ )**

TPC command	UL channel	Test requirement measured power
0 dB	PUSCH	Given 3 power measurements in the pattern, the 2 <sup>nd</sup> , and later measurements shall be within $\pm(3.5\text{dB}+\text{TT})$ of the 1 <sup>st</sup> measurement.
Note 1: TT for each duplex, Sub-Carrier Spacing, frequency and channel bandwidth is specified in Table 6.3A.4.4.2.5-4.		

**Table 6.3A.4.4.2.5-3: Test Tolerance ( $P_{\text{int}} \geq P \geq P_{\text{min}}$ )**

Test Metric	FR2a	FR2b
IFF (Quiet Zone size $\leq 30$ cm)	FFS	FFS

**Table 6.3A.4.4.2.5-4: Test Tolerance ( $P_{\max} \geq P > P_{\text{int}}$ )**

Test Metric	FR2a	FR2b
IFF (Quiet Zone size $\leq 30$ cm)	FFS	FFS

#### 6.3A.4.4.3 Aggregate power tolerance for CA (4UL CA)

**Editor's note:** This clause is incomplete. The following aspects are either missing or not yet determined:

Measurement Uncertainty and Test Tolerances are FFS.

UE transmitted power for PC 1, 2 and 4 are FFS.

Power window is FFS.

How to ensure equal PSD between component carriers is FFS.

##### 6.3A.4.4.3.1 Test purpose

To verify the ability of the UE transmitter to maintain its power during non-contiguous transmissions within 21ms in response to 0 dB commands with respect to the first UE transmission and all other power control parameters as specified in TS 38.213 [22] kept constant.

##### 6.3A.4.4.3.2 Test applicability

This test case applies to all types of NR UE release 16 and forward that supports FR2 4UL CA.

##### 6.3A.4.4.3.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.3A.4.4.0.

##### 6.3A.4.4.3.4 Test description

Same as in clause 6.3A.4.4.1.4 with the following exceptions:

- Instead of Table 6.3A.4.4.1.4.1-1 → use Table 6.3A.4.4.3.4-1.

**Table 6.3A.4.4.3.4-1: Test Configuration Table: PUSCH**

Default Conditions	
Test Environment as specified in TS 38.508-1 [10] subclause 4.1	Normal
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.	Mid range
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.	Highest aggregated BW of the CA configuration

Test SCS as specified in Table 5.3.5-1.					Highest	
Test Parameters						
Test ID	CC	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation (Note 1)
1	PCC	Default	Default	-	DFT-s-OFDM QPSK	Inner_Full
	SCC1				DFT-s-OFDM QPSK	Inner_Full
	SCC2				DFT-s-OFDM QPSK	Inner_Full
	SCC3				DFT-s-OFDM QPSK	Inner_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.						
NOTE 2: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".						

#### 6.3A.4.4.3.5 Test requirement

The requirement for the power measurements made in step 8 of the test procedure shall not exceed the values specified in Table 6.3A.4.4.3.5-1 and Table 6.3A.4.4.3.5-2. The power measurement period shall be 1 sub-frame (1ms).

**Table 6.3A.4.4.3.5-1: Power control tolerance ( $P_{int} \geq P \geq P_{min}$ )**

TPC command	UL channel	Test requirement measured power
0 dB	PUSCH	Given 3 power measurements in the pattern, the 2 <sup>nd</sup> , and later measurements shall be within $\pm(5.5\text{dB}+TT)$ of the 1 <sup>st</sup> measurement.
Note 1: TT for each duplex, Sub-Carrier Spacing, frequency and channel bandwidth is specified in Table 6.3A.4.4.3.5-3.		

**Table 6.3A.4.4.3.5-2: Power control tolerance ( $P_{max} \geq P > P_{int}$ )**

TPC command	UL channel	Test requirement measured power
0 dB	PUSCH	Given 3 power measurements in the pattern, the 2 <sup>nd</sup> , and later measurements shall be within $\pm(3.5\text{dB}+TT)$ of the 1 <sup>st</sup> measurement.
Note 1: TT for each duplex, Sub-Carrier Spacing, frequency and channel bandwidth is specified in Table 6.3A.4.4.3.5-4.		

**Table 6.3A.4.4.3.5-3: Test Tolerance ( $P_{int} \geq P \geq P_{min}$ )**

Test Metric	FR2a	FR2b
IFF (Quiet Zone size $\leq 30$ cm)	FFS	FFS

**Table 6.3A.4.4.3.5-4: Test Tolerance ( $P_{max} \geq P > P_{int}$ )**

Test Metric	FR2a	FR2b
IFF (Quiet Zone size $\leq 30$ cm)	FFS	FFS

#### 6.3A.4.4.4 Aggregate power tolerance for CA (5UL CA)

Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:

Measurement Uncertainty and Test Tolerances are FFS.

UE transmitted power for PC 1, 2 and 4 are FFS.

Power window is FFS.

How to ensure equal PSD between component carriers is FFS.

#### 6.3A.4.4.4.1 Test purpose

To verify the ability of the UE transmitter to maintain its power during non-contiguous transmissions within 21ms in response to 0 dB commands with respect to the first UE transmission and all other power control parameters as specified in TS 38.213 [22] kept constant.

#### 6.3A.4.4.4.2 Test applicability

This test case applies to all types of NR UE release 16 and forward that supports FR2 5UL CA.

#### 6.3A.4.4.4.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.3A.4.4.0.

#### 6.3A.4.4.4.4 Test description

Same as in clause 6.3A.4.4.1.4 with the following exceptions:

- Instead of Table 6.3A.4.4.1.4.1-1 → use Table 6.3A.4.4.4.4-1.

**Table 6.3A.4.4.4-1: Test Configuration Table: PUSCH**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.				Mid range		
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.				Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1.				Highest		
Test Parameters						
Test ID	CC	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation (Note 1)
1	PCC	Default	Default	-	DFT-s-OFDM QPSK	Inner_Full
	SCC1				DFT-s-OFDM QPSK	Inner_Full
	SCC2				DFT-s-OFDM QPSK	Inner_Full
	SCC3				DFT-s-OFDM QPSK	Inner_Full
	SCC4				DFT-s-OFDM QPSK	Inner_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.						
NOTE 2: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".						

#### 6.3A.4.4.4.5 Test requirement

The requirement for the power measurements made in step 8 of the test procedure shall not exceed the values specified in Table 6.3A.4.4.4.5-1 and Table 6.3A.4.4.4.5-2. The power measurement period shall be 1 sub-frame (1ms).

**Table 6.3A.4.4.4.5-1: Power control tolerance ( $P_{int} \geq P \geq P_{min}$ )**

TPC command	UL channel	Test requirement measured power
0 dB	PUSCH	Given 3 power measurements in the pattern, the 2 <sup>nd</sup> , and later measurements shall be within $\pm(5.5\text{dB}+TT)$ of the 1 <sup>st</sup> measurement.
Note 1: TT for each duplex, Sub-Carrier Spacing, frequency and channel bandwidth is specified in Table 6.3A.4.4.4.5-3.		

**Table 6.3A.4.4.4.5-2: Power control tolerance ( $P_{max} \geq P > P_{int}$ )**

TPC command	UL channel	Test requirement measured power
0 dB	PUSCH	Given 3 power measurements in the pattern, the 2 <sup>nd</sup> , and later measurements shall be within $\pm(3.5\text{dB}+TT)$ of the 1 <sup>st</sup> measurement.
Note 1: TT for each duplex, Sub-Carrier Spacing, frequency and channel bandwidth is specified in Table 6.3A.4.4.4.5-4.		

**Table 6.3A.4.4.4.5-3: Test Tolerance ( $P_{int} \geq P \geq P_{min}$ )**

Test Metric	FR2a	FR2b
IFF (Quiet Zone size $\leq$ 30 cm)	FFS	FFS

**Table 6.3A.4.4.4.5-4: Test Tolerance ( $P_{max} \geq P > P_{int}$ )**

Test Metric	FR2a	FR2b
IFF (Quiet Zone size $\leq$ 30 cm)	FFS	FFS

#### 6.3A.4.4.5 Aggregate power tolerance for CA (6UL CA)

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

**Measurement Uncertainty and Test Tolerances are FFS.**

**UE transmitted power for PC 1, 2 and 4 are FFS.**

**Power window is FFS.**

**How to ensure equal PSD between component carriers is FFS.**

##### 6.3A.4.4.5.1 Test purpose

To verify the ability of the UE transmitter to maintain its power during non-contiguous transmissions within 21ms in response to 0 dB commands with respect to the first UE transmission and all other power control parameters as specified in TS 38.213 [22] kept constant.

##### 6.3A.4.4.5.2 Test applicability

This test case applies to all types of NR UE release 16 and forward that supports FR2 6UL CA.

##### 6.3A.4.4.5.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.3A.4.4.0.

##### 6.3A.4.4.5.4 Test description

Same as in clause 6.3A.4.4.1.4 with the following exceptions:

- Instead of Table 6.3A.4.4.1.4.1-1  $\rightarrow$  use Table 6.3A.4.4.5.4-1.

**Table 6.3A.4.4.5-1: Test Configuration Table: PUSCH**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.				Mid range		
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.				Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1.				Highest		
Test Parameters						
Test ID	CC	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation (Note 1)
1	PCC	Default	Default	-	DFT-s-OFDM QPSK	Inner_Full
	SCC1				DFT-s-OFDM QPSK	Inner_Full
	SCC2				DFT-s-OFDM QPSK	Inner_Full
	SCC3				DFT-s-OFDM QPSK	Inner_Full
	SCC4				DFT-s-OFDM QPSK	Inner_Full
	SCC5				DFT-s-OFDM QPSK	Inner_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.						
NOTE 2: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".						

6.3A.4.4.5.5 Test requirement

The requirement for the power measurements made in step 8 of the test procedure shall not exceed the values specified in Table 6.3A.4.4.5.5-1 and Table 6.3A.4.4.5.5-2. The power measurement period shall be 1 sub-frame (1ms).

**Table 6.3A.4.4.5.5-1: Power control tolerance ( $P_{int} \geq P \geq P_{min}$ )**

TPC command	UL channel	Test requirement measured power
0 dB	PUSCH	Given 3 power measurements in the pattern, the 2 <sup>nd</sup> , and later measurements shall be within $\pm(5.5dB+TT)$ of the 1 <sup>st</sup> measurement.
Note 1: TT for each duplex, Sub-Carrier Spacing, frequency and channel bandwidth is specified in Table 6.3A.4.4.5.5-3.		

**Table 6.3A.4.4.5.5-2: Power control tolerance ( $P_{max} \geq P > P_{int}$ )**

TPC command	UL channel	Test requirement measured power
0 dB	PUSCH	Given 3 power measurements in the pattern, the 2 <sup>nd</sup> , and later measurements shall be within $\pm(3.5dB+TT)$ of the 1 <sup>st</sup> measurement.
Note 1: TT for each duplex, Sub-Carrier Spacing, frequency and channel bandwidth is specified in Table 6.3A.4.4.5.5-4.		

**Table 6.3A.4.4.5.5-3: Test Tolerance ( $P_{int} \geq P \geq P_{min}$ )**

Test Metric	FR2a	FR2b
IFF (Quiet Zone size $\leq 30$ cm)	FFS	FFS

**Table 6.3A.4.4.5.5-4: Test Tolerance ( $P_{\max} \geq P > P_{\text{int}}$ )**

Test Metric	FR2a	FR2b
IFF (Quiet Zone size $\leq 30$ cm)	FFS	FFS

#### 6.3A.4.4.6 Aggregate power tolerance for CA (7UL CA)

Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:

Measurement Uncertainty and Test Tolerances are FFS.

UE transmitted power for PC 1, 2 and 4 are FFS.

Power window is FFS.

How to ensure equal PSD between component carriers is FFS.

##### 6.3A.4.4.6.1 Test purpose

To verify the ability of the UE transmitter to maintain its power during non-contiguous transmissions within 21ms in response to 0 dB commands with respect to the first UE transmission and all other power control parameters as specified in TS 38.213 [22] kept constant.

##### 6.3A.4.4.6.2 Test applicability

This test case applies to all types of NR UE release 16 and forward that supports FR2 7UL CA.

##### 6.3A.4.4.6.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.3A.4.4.0.

##### 6.3A.4.4.6.4 Test description

Same as in clause 6.3A.4.4.1.4 with the following exceptions:

- Instead of Table 6.3A.4.4.1.4.1-1 → use Table 6.3A.4.4.6.4-1.

**Table 6.3A.4.4.6.4-1: Test Configuration Table: PUSCH**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.				Mid range		
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.				Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1.				Highest		
Test Parameters						
Test ID	CC	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation (Note 1)
1	PCC	Default	Default	-	DFT-s-OFDM QPSK	Inner_Full
	SCC1				DFT-s-OFDM QPSK	Inner_Full
	SCC2				DFT-s-OFDM QPSK	Inner_Full
	SCC3				DFT-s-OFDM QPSK	Inner_Full
	SCC4				DFT-s-OFDM QPSK	Inner_Full
	SCC5				DFT-s-OFDM QPSK	Inner_Full

	SCC6				DFT-s-OFDM QPSK	Inner_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1. NOTE 2: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".						

6.3A.4.4.6.5 Test requirement

The requirement for the power measurements made in step 8 of the test procedure shall not exceed the values specified in Table 6.3A.4.4.6.5-1 and Table 6.3A.4.4.6.5-2. The power measurement period shall be 1 sub-frame (1ms).

**Table 6.3A.4.4.6.5-1: Power control tolerance ( $P_{int} \geq P \geq P_{min}$ )**

TPC command	UL channel	Test requirement measured power
0 dB	PUSCH	Given 3 power measurements in the pattern, the 2 <sup>nd</sup> , and later measurements shall be within $\pm(5.5dB+TT)$ of the 1 <sup>st</sup> measurement.
Note 1: TT for each duplex, Sub-Carrier Spacing, frequency and channel bandwidth is specified in Table 6.3A.4.4.6.5-3.		

**Table 6.3A.4.4.6.5-2: Power control tolerance ( $P_{max} \geq P > P_{int}$ )**

TPC command	UL channel	Test requirement measured power
0 dB	PUSCH	Given 3 power measurements in the pattern, the 2 <sup>nd</sup> , and later measurements shall be within $\pm(3.5dB+TT)$ of the 1 <sup>st</sup> measurement.
Note 1: TT for each duplex, Sub-Carrier Spacing, frequency and channel bandwidth is specified in Table 6.3A.4.4.6.5-4.		

**Table 6.3A.4.4.6.5-3: Test Tolerance ( $P_{int} \geq P \geq P_{min}$ )**

Test Metric	FR2a	FR2b
IFF (Quiet Zone size $\leq 30$ cm)	FFS	FFS

**Table 6.3A.4.4.6.5-4: Test Tolerance ( $P_{max} \geq P > P_{int}$ )**

Test Metric	FR2a	FR2b
IFF (Quiet Zone size $\leq 30$ cm)	FFS	FFS

6.3A.4.4.7 Aggregate power tolerance for CA (8UL CA)

Editor’s note: This clause is incomplete. The following aspects are either missing or not yet determined:

Measurement Uncertainty and Test Tolerances are FFS.

UE transmitted power for PC 1, 2 and 4 are FFS.

Power window is FFS.

How to ensure equal PSD between component carriers is FFS.



6.3A.4.4.7.1 Test purpose

To verify the ability of the UE transmitter to maintain its power during non-contiguous transmissions within 21ms in response to 0 dB commands with respect to the first UE transmission and all other power control parameters as specified in TS 38.213 [22] kept constant.

6.3A.4.4.7.2 Test applicability

This test case applies to all types of NR UE release 16 and forward that supports FR2 8UL CA.

6.3A.4.4.7.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.3A.4.4.0.

6.3A.4.4.7.4 Test description

Same as in clause 6.3A.4.4.1.4 with the following exceptions:

- Instead of Table 6.3A.4.4.1.4.1-1 → use Table 6.3A.4.4.7.4-1.

**Table 6.3A.4.4.7.4-1: Test Configuration Table: PUSCH**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.				Mid range		
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.				Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1.				Highest		
Test Parameters						
Test ID	CC	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation (Note 1)
1	PCC	Default	Default	-	DFT-s-OFDM QPSK	Inner_Full
	SCC1				DFT-s-OFDM QPSK	Inner_Full
	SCC2				DFT-s-OFDM QPSK	Inner_Full
	SCC3				DFT-s-OFDM QPSK	Inner_Full
	SCC4				DFT-s-OFDM QPSK	Inner_Full
	SCC5				DFT-s-OFDM QPSK	Inner_Full
	SCC6				DFT-s-OFDM QPSK	Inner_Full
	SCC7				DFT-s-OFDM QPSK	Inner_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.						
NOTE 2: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".						

6.3A.4.4.7.5 Test requirement

The requirement for the power measurements made in step 8 of the test procedure shall not exceed the values specified in Table 6.3A.4.4.7.5-1 and Table 6.3A.4.4.7.5-2. The power measurement period shall be 1 sub-frame (1ms).

**Table 6.3A.4.4.7.5-1: Power control tolerance ( $P_{int} \geq P \geq P_{min}$ )**

TPC command	UL channel	Test requirement measured power
0 dB	PUSCH	Given 3 power measurements in the pattern, the 2 <sup>nd</sup> , and later measurements shall be within $\pm(5.5\text{dB}+TT)$ of the 1 <sup>st</sup> measurement.
Note 1: TT for each duplex, Sub-Carrier Spacing, frequency and channel bandwidth is specified in Table 6.3A.4.4.7.5-3.		

**Table 6.3A.4.4.7.5-2: Power control tolerance ( $P_{max} \geq P > P_{int}$ )**

TPC command	UL channel	Test requirement measured power
0 dB	PUSCH	Given 3 power measurements in the pattern, the 2 <sup>nd</sup> , and later measurements shall be within $\pm(3.5\text{dB}+TT)$ of the 1 <sup>st</sup> measurement.
Note 1: TT for each duplex, Sub-Carrier Spacing, frequency and channel bandwidth is specified in Table 6.3A.4.4.7.5-4.		

**Table 6.3A.4.4.7.5-3: Test Tolerance ( $P_{int} \geq P \geq P_{min}$ )**

Test Metric	FR2a	FR2b
IFF (Quiet Zone size $\leq 30$ cm)	FFS	FFS

**Table 6.3A.4.4.7.5-4: Test Tolerance ( $P_{max} \geq P > P_{int}$ )**

Test Metric	FR2a	FR2b
IFF (Quiet Zone size $\leq 30$ cm)	FFS	FFS

## 6.3D Output power dynamics for UL MIMO

### 6.3D.0 General

The requirements in subclause 6.3D shall be met with configurations specified in sub-clause 6.2D.1.1.3.x, where 'x' depends on power class. Unless otherwise specified, the requirements shall be verified in beam locked mode with the test metric of EIRP (Link=TX beam peak direction, Meas=Link angle).

### 6.3D.1 Minimum output power for UL MIMO

**Editor's Note:** This clause is incomplete. The following aspects are either missing or not yet determined:

- Measurement Uncertainty and Test Tolerances are FFS.
- OTA test procedure for UL MIMO is still under investigation
- TP analysis is FFS.

#### 6.3D.1.1 Test purpose

To verify the UE's ability to transmit with a broadband output power below the value specified in the test requirement when the power is set to a minimum value.

#### 6.3D.1.2 Test applicability

This test case applies to all types of NR UE release 15 and forward supporting UL MIMO.

### 6.3D.1.3 Minimum conformance requirements

The minimum output power is defined as the mean power in at least one subframe (1ms). The minimum controlled output power is defined as the EIRP, i.e. the sum of the power in the channel bandwidth for all transmit bandwidth configurations (resource blocks), when the UE power is set to a minimum value.

#### 6.3D.1.3.1 Minimum output power for UL MIMO for power class 1

For UE supporting UL MIMO, the minimum output power shall not exceed the sum of the values specified in Table 6.3.1.3.1-1 and the quantity  $10 \cdot \log_{10}(\text{Number of Layers})$ .

#### 6.3D.1.3.2 Minimum output power for UL MIMO for power class 2, 3 and 4

For UE supporting UL MIMO, the minimum output power shall not exceed the values specified in Table 6.3.1.3.2-1 and the quantity  $10 \cdot \log_{10}(\text{Number of Layers})$ .

The normative reference for this requirement is TS 38.101-2 [3] clause 6.3D.1.

### 6.3D.1.4 Test description

#### 6.3D.1.4.1 Initial condition

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, test channel bandwidths and sub-carrier spacing based on NR operating bands specified in Table 5.2-1. All of these configurations shall be tested with applicable test parameters for each combination of test channel bandwidth and sub-carrier spacing, and are shown in Table 6.3D.1.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.3D.1.4.1-1: Test Configuration Table**

Initial Conditions			
Test Environment as specified in TS 38.508-1 [10] subclause 4.1		Normal	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1		Low range, Mid range, High range	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1		Lowest, Mid, Highest	
Test SCS as specified in Table 5.3.5-1.		Highest	
Test Parameters			
Test ID	Downlink Configuration		Uplink Configuration
	-		Modulation
1			RB allocation (NOTE 1)
			CP-OFDM QPSK
			Outer_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.			

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] clause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement Channel is set according to Table 6.3D.1.4.1-1.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in State RRC\_CONNECTED with generic procedure parameters Connectivity NR, Connected without release On, Test Mode On and Test Loop Function On according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.3D.1.4.3.

### 6.3D.1.4.2 Test procedure

1. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.3D.1.4.1-1. Since the UE has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC. The PDCCH DCI format 0\_1 is specified with the condition 2TX\_UL\_MIMO in 38.508-1 [5] subclause 4.3.6.1.1.2.
2. Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
3. Send continuously uplink power control "down" commands in every uplink scheduling information to the UE; allow at least 200ms starting from the first TPC command in this step to ensure that the UE transmits at its minimum output power. If UE is disconnected, repeat the test case. Optionally, send continuously uplink power control "down" commands in every uplink scheduling information to the UE until the UE EIRP measured by the test system is at a level just before the UE was disconnected. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
4. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
5. Measure UE EIRP in the Tx beam peak direction in the measurement bandwidth specified in Table 6.3D.1.5-1 and Table 6.3D.1.5-2 for the specific channel bandwidth under test. EIRP test procedure is defined in Annex K. The measuring duration is at least one active uplink subframe. EIRP is calculated considering both polarizations, theta and phi. For TDD slots with transient periods are not under test.
6. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

### 6.3D.1.4.3 Message contents

Message contents are according to TS 38.508-1 [5] subclause 4.6 ensuring Table 4.6.3-182 with condition 2TX\_UL\_MIMO.

### 6.3D.1.5 Test requirement

The minimum EIRP, derived in step 5 shall not exceed the values specified in Table 6.3D.1.5-1 and Table 6.3D.1.5-2.

**Table 6.3D.1.5-1: Minimum output power for power class 1**

Operating band	Channel bandwidth (MHz)	Minimum output power (dBm)	Measurement bandwidth (MHz)
n257, n258, n260, n261	50	4+TT	47.58
	100	4+TT	95.16
	200	4+TT	190.20
	400	4+TT	380.28

**Table 6.3D.1.5-2: Minimum output power for power class 2, 3, and 4**

Operating band	Channel bandwidth (MHz)	Minimum output power (dBm)	Measurement bandwidth (MHz)
n257, n258, n260, n261	50	-13+TT	47.58
	100	-13+TT	95.16
	200	-13+TT	190.20
	400	-13+TT	380.28

## 6.3D.2 Transmit OFF power for UL MIMO

**Editor's Note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- Measurement Uncertainty and Test Tolerances are FFS.
- The testability of this test case is pending further analysis on relaxation of the requirement.
- OTA test procedure for UL-MIMO is still under investigation.
- Measurement grid for PC2/4 in Annex M.4 is TBD.

### 6.3D.2.1 Test purpose

To verify that the UE transmit OFF power is lower than the value specified in the test requirement.

An excess transmit OFF power potentially increases the Rise Over Thermal (RoT) and therefore reduces the cell coverage area for other UEs.

### 6.3D.2.2 Test applicability

This test applies to all types of NR UE release 15 and forward supporting UL MIMO.

### 6.3D.2.3 Minimum conformance requirements

For UE supporting UL MIMO, the transmit OFF power is defined as the TRP in the channel bandwidth when the transmitter is OFF. The transmitter is considered OFF when the UE is not allowed to transmit on any of its ports. During DTX and measurements gaps, the transmitter is not considered OFF. The minimum output power shall not exceed the values specified in Table 6.3.2.3-1. The requirement is verified with the test metric of TRP (Link=TX beam peak direction, Meas=TRP grid).

The normative reference for this requirement is TS 38.101-2 [3] clause 6.3D.2.

### 6.3D.2.4 Test description

#### 6.3D.2.4.1 Initial condition

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, test channel bandwidths and sub-carrier spacing based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each combination of test channel bandwidth and sub-carrier spacing, and are shown in Table 6.3D.2.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.3D.2.4.1-1: Test Configuration Table**

Initial Conditions				
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1			Low range, Mid range, High range	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1			Lowest	
Test SCS as specified in Table 5.3.5-1.			Highest	
Test Parameters				
Test ID	Downlink Configuration		Uplink Configuration	
	Modulation	RB allocation	Modulation	RB allocation
1	-	-	-	-

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.

3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement Channels are set according to Table 6.3D.2.4.1-1.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in State RRC\_CONNECTED with generic procedure parameters Connectivity NR, Connected without release On, Test Mode On and Test Loop Function On according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.3D.2.4.3.

#### 6.3D.2.4.2 Test procedure

1. Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE) for the UE Tx beam selection to complete.
2. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
3. Measure UE TRP for the assigned NR channel with a rectangular measurement filter with bandwidths according to Table 6.3D.2.5-1. Total radiated power is measured according to TRP measurement procedure defined in Annex K. TRP is calculated considering both polarizations, theta and phi.

NOTE: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

#### 6.3D.2.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 ensuring Table 4.6.3-182 with condition 2TX\_UL\_MIMO.

#### 6.3D.2.5 Test requirement

The requirement for the transmit OFF power shall not exceed the values specified in Table 6.3D.2.5-1.

**Table 6.3D.2.5-1: Transmit OFF power**

Operating band	Channel bandwidth / Transmit OFF power (dBm) / measurement bandwidth			
	50 MHz	100 MHz	200 MHz	400 MHz
n257 <sup>2</sup>	-35+[21.4]	-35+[24.4]	-35+[27.4]	-35+[30.4]
	47.58 MHz	95.16 MHz	190.20 MHz	380.28 MHz
n258, n261	-35+[21.4]	-35+[24.4]	-35+[27.4]	-35+[30.4]
	47.58 MHz	95.16 MHz	190.20 MHz	380.28 MHz
n260	-35+[24.1]	-35+[27.1]	-35+[30.1]	-35+[33.1]
	47.58 MHz	95.16 MHz	190.20 MHz	380.28 MHz
[NOTE 1: Core requirement cannot be tested due to testability issue and test requirement includes relaxation to achieve impact from test system noise to measurement result = 1.0 dB (Minimum requirement + relaxation).]				
[NOTE 2: Relaxed n257 test requirement is testable for PC3.]				

### 6.3D.3 Transmit ON/OFF time mask for UL MIMO

#### 6.3D.3.1 General ON/OFF time mask for UL MIMO

**Editor's Note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- Measurement Uncertainty and Test Tolerances are FFS.
- Test requirement of ON power is FFS.
- Testability of OFF power needs further study.
- OTA test procedure for UL-MIMO is still under investigation

- TP analysis is FFS.

#### 6.3D.3.1.1 Test purpose

To verify that the general ON/OFF time mask meets the requirements given in 6.3D.3.1.5. Transmission of the wrong power increases interference to other channels, or increases transmission errors in the uplink channel.

#### 6.3D.3.1.2 Test applicability

This test case applies to all types of NR UE release 15 and forward supporting UL MIMO.

#### 6.3D.3.1.3 Minimum conformance requirements

For UE supporting UL MIMO, the ON/OFF time mask requirements in subclause 6.3.3 apply.

The normative reference for this requirement is TS 38.101-2 [3] clause 6.3D.3.

#### 6.3D.3.1.4 Test description

##### 6.3D.3.1.4.1 Initial condition

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, test channel bandwidths and sub-carrier spacing based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each combination of test channel bandwidth and sub-carrier spacing, and are shown in Table 6.3D.3.1.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.3D.3.1.4.1-1: Test Configuration Table**

Initial Conditions			
Test Environment as specified in TS 38.508-1 [10] subclause 4.1		Normal, TL, TH	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1		Low range, Mid range, High range	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1		Lowest, Mid, Highest	
Test SCS as specified in Table 5.3.5-1.		Highest	
Test Parameters			
Test ID	Downlink Configuration		Uplink Configuration
	-		Modulation RB allocation (NOTE 1)
1			CP-OFDM QPSK Outer_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.			

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement Channels are set according to Table 6.3D.3.1.4.1-1.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in State RRC\_CONNECTED with generic procedure parameters Connectivity NR, Connected without release On, Test Mode On and Test Loop Function On according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.3D.3.1.4.3.

6.3D.3.1.4.2 Test procedure

1. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.3D.3.1.4.1-1. Since the UE has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC. The PDCCH DCI format 0\_1 is specified with the condition 2TX\_UL\_MIMO in 38.508-1 [5] subclause 4.3.6.1.1.2.
2. Set the UE in the Inband Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE) for the UE Tx beam selection to complete.
3. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
4. For UE transmission OFF power, measure UE EIRP in the Tx beam peak direction in the channel bandwidth of the radio access mode according to the test configuration, which shall meet the requirements described in Table 6.3D.3.1.5-1. EIRP test procedure is defined in Annex K. The period of the measurement shall be the slot prior to the PUSCH transmission, excluding a transient period of 5 μs in the end of the slot and any DL periods. EIRP is calculated considering both polarizations, theta and phi.
5. For UE transmission ON power, measure UE EIRP in the Tx beam peak direction in the channel bandwidth of the radio access mode according to the test configuration, which shall meet the requirements described in Table 6.3D.3.1.5-2. EIRP test procedure is defined in Annex K. The period of the measurement shall be one slot with PUSCH transmission. EIRP is calculated considering both polarizations, theta and phi. For TDD slots with transient periods are not under test.
6. For UE transmission OFF power, measure UE EIRP in the Tx beam peak direction in the channel bandwidth of the radio access mode according to the test configuration, which shall meet the requirements described in Table 6.3D.3.1.5-1. EIRP test procedure is defined in Annex K. The period of the measurement shall be the slot following the PUSCH transmission, excluding a transient period of 5 μs at the beginning of the slot and any DL periods. EIRP is calculated considering both polarizations, theta and phi.
7. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

NOTE: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

6.3D.3.1.4.3 Message contents

Message contents are according to TS 38.508-1 [5] subclause 4.6 ensuring Table 4.6.3-182 with condition 2TX\_UL\_MIMO.

**Table 6.3D.3.1.4.3-1: PUSCH-ConfigCommon**

Derivation Path: TS 38.508-1[10], Table 4.6.3-119			
Information Element	Value/remark	Comment	Condition
PUSCH-ConfigCommon ::= SEQUENCE {			
p0-NominalWithGrant	-102		50MHz
	-106		100MHz
	-108		200MHz
	-112		400MHz
}			

**Table 6.3D.3.1.4.3-2: ServingCellConfigCommon**

Derivation Path: 38.508-1[5], Table 4.6.3-168			
Information Element	Value/remark	Comment	Condition
ServingCellConfigCommon ::= SEQUENCE {			
ss-PBCH-BlockPower	4		SCS_120kHz
	7		SCS_240kHz
}			



Condition	Explanation
SCS_120kHz	SCS=120kHz for SS/PBCH block
SCS_240kHz	SCS=240kHz for SS/PBCH block

**Table 6.3D.3.1.4.3-3: PUSCH-PowerControl**

Derivation Path: TS 38.508-1 [10], Table 4.6.3-120			
Information Element	Value/remark	Comment	Condition
PUSCH-PowerControl ::= SEQUENCE {			
tpc-Accumulation	disabled		
p0-AlphaSets SEQUENCE (SIZE (1..maxNrofP0-PUSCH-AlphaSets)) OF SEQUENCE {	1 entry		
P0-PUSCH-AlphaSet[1] SEQUENCE {			
alpha	alpha1		
}			
}			
}			

6.3D.3.1.5 Test requirement

The requirement for the EIRP measured in steps 4, 5 and 6 of the test procedure shall not exceed the values specified in Table 6.3D.3.1.5-1 and 6.3D.3.1.5-2.

**Table 6.3D.3.1.5-1: Test requirement of OFF power of General ON/OFF time mask for UL MIMO**

	Channel bandwidth / minimum output power / measurement bandwidth			
	50 MHz	100 MHz	200 MHz	400 MHz
Transmit OFF power	≤ -30+TT dBm			
Transmission OFF Measurement bandwidth	47.58 MHz	95.16 MHz	190.20 MHz	380.28 MHz
Note 1:	Core requirements cannot be tested due to testability issue and test requirement includes relaxation to achieve impact from test system noise to measurement results = 1.0 dB (Minimum requirement + relaxation R).			
Note 2:	Relaxation R is specified in Table 6.3D.3.1.5-3.			

**Table 6.3D.3.1.5-2: Test requirement of ON power of General ON/OFF time mask for UL MIMO**

	SCS [kHz]	Channel bandwidth / measurement bandwidth			
		50 MHz	100 MHz	200 MHz	400 MHz
Expected Transmission ON power for DFT-s-OFDM	60	22.1	21.1	22.1	N/A
	120	22.1	21.1	22.1	21.1
Power tolerance	± (14+TT)dB				
Note 1:	The lower power limit shall not exceed the minimum output power requirements defined in sub-clause 6.3.2.3, and the higher power limit shall not exceed the Max EIRP defined in sub-clause 6.2.1.3.				

**Table 6.3D.3.1.5-3: Relaxation required for OFF power for PC3 UEs**

Operating band	50 MHz	100 MHz	200 MHz	400 MHz
n257, n258, n261	[19.4] dB	[22.4] dB	[25.4] dB	[28.4] dB
n260	[21.5] dB	[24.5] dB	[27.5] dB	[30.5] dB

**Table 6.3D.3.1.5-4: Test Tolerance for ON power**

FFS

6.3D.3.2 Void

6.3D.3.3 Void

6.3D.3.4 Void

## 6.4 Transmit signal quality

### 6.4.1 Frequency error

#### 6.4.1.1 Test purpose

This test verifies the ability of both, the receiver and the transmitter, to process frequency correctly.

Receiver: to extract the correct frequency from the stimulus signal, offered by the System simulator, under ideal propagation conditions and low level.

Transmitter: to derive the correct modulated carrier frequency from the results, gained by the receiver.

#### 6.4.1.2 Test applicability

This test case applies to all types of NR UE release 15 and forward.

#### 6.4.1.3 Minimum conformance requirements

The UE basic measurement interval of modulated carrier frequency is 1 UL slot. The mean value of basic measurements of UE modulated carrier frequency shall be accurate to within  $\pm 0.1$  PPM observed over a period of 1 msec of cumulated measurement intervals compared to the carrier frequency received from the NR gNB.

The frequency error is defined as a directional requirement. The requirement is verified in beam locked mode with the test metric of Frequency (Link=TX beam peak direction, Meas=Link angle).

The normative reference for this requirement is TS 38.101-2 [3] clause 6.4.1

#### 6.4.1.4 Test description

##### 6.4.1.4.1 Initial condition

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, test channel bandwidths and sub-carrier spacing based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each combination of channel bandwidth and sub-carrier spacing, are shown in Table 6.4.1.4.1-1. The details of the uplink and downlink reference measurement channels (RMCs) are specified in Annexes A.2 and A.3. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.4.1.4.1-1: Test Configuration Table**

Initial Conditions	
Test Environment as specified in TS 38.508-1 [10] subclause 4.1	Normal, TL, TH
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1	Mid range
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1	Highest

Test SCS as specified in Table 5.3.5-1.			Lowest	
Test Parameters				
Test ID	Downlink Configuration		Uplink Configuration	
	Modulation	RB allocation	Modulation	RB allocation
1	CP-OFDM QPSK	Full RB (NOTE 1)	DFT-s-OFDM QPSK	REFSENS (NOTE 2)
NOTE 1: Full RB allocation shall be used per each SCS and channel BW as specified in Table 7.3.2.4.1-2.				
NOTE 2: REFSENS refers to Table 7.3.2.4.1-3 which defines uplink RB configuration and start RB location for each SCS, channel BW and NR band.				

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and section A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The DL and UL Reference Measurement channels are set according to Table 6.4.1.4.1-1.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.4.1.4.3

#### 6.4.1.4.2 Test procedure

1. Retrieve the LO position from the parameter txDirectCurrentLocation in UplinkTxDirectCurrent IE.
2. SS transmits PDSCH via PDCCH DCI format 1\_1 for C\_RNTI to transmit the DL RMC according to Table 6.4.1.4.1-1. The SS sends downlink MAC padding bits on the DL RMC.
3. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.4.1.4.1-1. Since the UL has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC.
5. Set the UE in the Inband Tx beam peak direction and apply the associated polarization for the DL, both found with a 3D EIRP scan as performed in Annex K.1.1. Connect the SS (System Simulator) with the DUT through the measurement antenna with polarization reference Pol<sub>Link</sub> to form the TX beam towards the TX beam peak direction and respective polarization. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
4. Send continuously uplink power control "up" commands to the UE in every uplink scheduling information to the UE so that the UE transmits at P<sub>UMAX</sub> level for the duration of the test. Allow at least 200ms starting from the first TPC Command for the UE to reach P<sub>UMAX</sub> level. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
6. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition TxRx.
7. Measure the Frequency Error using Global In-Channel Tx-Test (Annex E) for the  $\theta$ - and  $\phi$ -polarization of the UL. For TDD, only slots consisting of only UL symbols are under test.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

#### 6.4.1.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with DFT-s-OFDM condition in Table 4.6.3-118 PUSCH-Config.

#### 6.4.1.5 Test requirement

The 10 frequency error  $\Delta f$  results for the  $\theta$ -polarization or the 10 frequency error  $\Delta f$  results for the  $\phi$ -polarization must fulfil the test requirement:

$$|\Delta f| \leq (0.1 \text{ PPM} + 0.005 \text{ PPM}),$$

## 6.4.2 Transmit modulation quality

Transmit modulation quality defines the modulation quality for expected in-channel RF transmissions from the UE. The transmit modulation quality is specified in terms of:

- Error Vector Magnitude (EVM) for the allocated resource blocks (RBs)
- EVM equalizer spectrum flatness derived from the equalizer coefficients generated by the EVM measurement process
- Carrier leakage
- In-band emissions for the non-allocated RB

All the parameters defined in subclause 6.4.2 are defined using the measurement methodology specified in Annex E.

All the requirements in 6.4.2 are defined as directional requirement. The requirements are verified in beam locked mode on beam peak direction, with parameter *maxRank* (as defined in TS 38.331 [19]) set to 1. The requirements are applicable to UL transmission from each configurable antenna port (as defined in TS 38.331 [19]) of UE, enabled one at a time.

In case the parameter 3300 or 3301 is reported from UE via *txDirectCurrentLocation* IE (as defined in TS 38.331 [19]), carrier leakage measurement requirement in subclause 6.4.2.2 and 6.4.2.3 shall be waived, and the RF correction with regard to the carrier leakage and IQ image shall be omitted during the calculation of transmit modulation quality.

### 6.4.2.1 Error vector magnitude

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- **Measurement Uncertainty and Test Tolerance are FFS except for PUSCH, PC3 in FR2a and FR2b.**

#### 6.4.2.1.1 Test Purpose

The Error Vector Magnitude is a measure of the difference between the reference waveform and the measured waveform. This difference is called the error vector. Before calculating the EVM, the measured waveform is corrected by the sample timing offset and RF frequency offset. Then the carrier leakage shall be removed from the measured waveform before calculating the EVM.

The measured waveform is further equalised using the channel estimates subjected to the EVM equaliser spectrum flatness requirement specified in sub-clauses 6.4.2.4.3 and 6.4.2.5.3. For DFT-s-OFDM waveforms, the EVM result is defined after the front-end FFT and IDFT as the square root of the ratio of the mean error vector power to the mean reference power expressed as a %. For CP-OFDM waveforms, the EVM result is defined after the front-end FFT as the square root of the ratio of the mean error vector power to the mean reference power expressed as a %.

The basic EVM measurement interval in the time domain is one preamble sequence for the PRACH and the duration of PUCCH/PUSCH channel, or one hop, if frequency hopping is enabled for PUCCH and PUSCH in the time domain. The EVM measurement interval is reduced by any symbols that contain an allowable power transient as defined in subclause 6.3.3.3.

#### 6.4.2.1.2 Test applicability

This test case applies to all types of NR UE release 15 and forward.

#### 6.4.2.1.3 Minimum conformance requirements

The RMS average of the basic EVM measurements for the average EVM case, and for the reference signal EVM case, for the different modulation schemes shall not exceed the values specified in Table 6.4.2.1.3-1 for the parameters defined in Table 6.4.2.1.3-2 or Table 6.4.2.1.3-3 depending on UE power class. For EVM evaluation purposes, all 13 PRACH preamble formats and all 5 PUCCH formats are considered to have the same EVM requirement as QPSK modulated.

The measurement interval for the EVM determination is 10 subframes. The requirement is verified with the test metric of EVM (Link=TX beam peak direction, Meas=Link angle).

**Table 6.4.2.1.3-1: Minimum requirements for error vector magnitude**

Parameter	Unit	Average EVM level	Reference signal EVM level
Pi/2 BPSK	%	30.0	30.0
QPSK	%	17.5	17.5
16 QAM	%	12.5	12.5
64 QAM	%	8.0	8.0

**Table 6.4.2.1.3-2: Parameters for Error Vector Magnitude for power class 1**

Parameter	Unit	Level
UE EIRP	dBm	≥ 4
UE EIRP for UL 16QAM	dBm	≥ 7
UE EIRP for UL 64QAM	dBm	≥ 11
Operating conditions		Normal conditions

**Table 6.4.2.1.3-3: Parameters for Error Vector Magnitude for power class 2, 3, and 4**

Parameter	Unit	Level
UE EIRP	dBm	≥ -13
UE EIRP for UL 16QAM	dBm	≥ -10
UE EIRP for UL 64QAM	dBm	≥ -6
Operating conditions		Normal conditions

The normative reference for this requirement is TS 38.101-2 [3] clause 6.4.2.1.

#### 6.4.2.1.4 Test description

##### 6.4.2.1.4.1 Initial conditions

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, test channel bandwidths and sub-carrier spacing based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each combination of channel bandwidth and sub-carrier spacing, are shown in Table 6.4.2.1.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annex A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.4.2.1.4.1-1: Test Configuration Table for PUSCH**

Initial Conditions			
Test Environment as specified in TS 38.508-1 [10] subclause 4.1		Normal	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1		Low range, Mid range, High range	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1		Lowest, Highest	
Test SCS as specified in Table 5.3.5-1		Lowest, Highest	
Test Parameters			
Test ID	Downlink Configuration	Uplink Configuration	
	-	Modulation	RB allocation (NOTE 1)
1		DFT-s-OFDM Pi/2 BPSK	Inner_Full for PC2, PC3 and PC4 Inner_Full_Region1 for PC1
2		DFT-s-OFDM Pi/2 BPSK	Outer_Full
3		DFT-s-OFDM QPSK	Inner_Full for PC2, PC3 and PC4

		Inner_Full_Region1 for PC1
4	DFT-s-OFDM QPSK	Outer_Full
5	DFT-s-OFDM 16 QAM	Inner_Full for PC2, PC3 and PC4 Inner_Full_Region1 for PC1
6	DFT-s-OFDM 16 QAM	Outer_Full
7	DFT-s-OFDM 64 QAM	Inner_Full for PC2, PC3 and PC4 Inner_Full_Region1 for PC1
8	DFT-s-OFDM 64 QAM	Outer_Full
9	CP-OFDM QPSK	Inner_Full for PC2, PC3 and PC4 Inner_Full_Region1 for PC1
10	CP-OFDM QPSK	Outer_Full
11	CP-OFDM 16 QAM	Inner_Full for PC2, PC3 and PC4 Inner_Full_Region1 for PC1
12	CP-OFDM 16 QAM	Outer_Full
13	CP-OFDM 64 QAM	Inner_Full for PC2, PC3 and PC4 Inner_Full_Region1 for PC1
14	CP-OFDM 64 QAM	Outer_Full
<p>NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.</p> <p>NOTE 2: Test Channel Bandwidths are checked separately for each NR band, which applicable channel bandwidths are specified in Table 5.3.5-1.</p> <p>NOTE 3: The following test points are not testable for PC3 devices:                      FR2a channel bandwidth 200MHz: test points 8, 13 and 14                      FR2a channel bandwidth 400MHz: test points 7, 8, 11, 12, 13 and 14                      FR2b channel bandwidth 50MHz: test points 13 and 14                      FR2b channel bandwidth 100MHz: test points 7, 8, 13 and 14                      FR2b channel bandwidth 200MHz: test points 7, 8, 13 and 14                      FR2b channel bandwidth 400MHz: test points 5, 6, 7, 8, 11, 12, 13 and 14</p>		

**Table 6.4.2.1.4.1-2: Test Configuration Table for PUCCH**

Initial Conditions				
Test Environment as specified in TS 38.508-1 [10] subclause 4.1		Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1		See Table 6.4.2.1.4.1-1		
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1		See Table 6.4.2.1.4.1-1		
Test SCS as specified in Table 5.3.5-1		See Table 6.4.2.1.4.1-1		
Test Parameters				
ID	Downlink Configuration		Uplink Configuration	
	Modulation	RB allocation	Waveform	PUCCH format
1	CP-OFDM QPSK	Full RB (Note 1)	CP-OFDM	PUCCH format = Format 1 Length in OFDM symbols = 14
2	CP-OFDM QPSK	Full RB (Note 1)	DFT-s-OFDM	PUCCH format = Format 3 Length in OFDM symbols = 14
NOTE 1: Full RB allocation shall be used per each SCS and channel BW as specified in Table 7.3.2.4.1-2.				
NOTE 2: Test Channel Bandwidths are checked separately for each NR band, which applicable channel bandwidths are specified in Table 5.3.5-1.				

**Table 6.4.2.1.4.1-3: Test Configuration for PRACH**

Initial Conditions	
Test Environment as specified in TS 38.508-1 [10] subclause 4.1	Normal
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1	See Table 6.4.2.1.4.1-1
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1	See Table 6.4.2.1.4.1-1
Test SCS as specified in Table 5.3.5-1	See Table 6.4.2.1.4.1-1
PRACH preamble format	
PRACH Configuration Index	52

SS/PBCH SSS EPRE setting (dBm/120kHz)	-96
---------------------------------------	-----

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, in Figure A.3.3.1.1 for TE diagram and section A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement channels are set according to Table 6.4.2.1.4.1-1.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.4.2.1.4.3

#### 6.4.2.1.4.2 Test procedure

Test procedure for PUSCH:

1.1 Retrieve the LO position from the parameter txDirectCurrentLocation in UplinkTxDirectCurrent IE.

1.2 SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.4.2.1.4.1-1. Since the UE has no payload data to send, the UE transmits uplink MAC padding bits on the UL RMC.

1.3 Set the UE in the Inband Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 2) for the UE Tx beam selection to complete.

1.4 Send continuously uplink power control "up" commands in the uplink scheduling information to the UE until the UE transmits at  $P_{UMAX}$  level. Allow at least 200 ms starting from the first TPC command in this step for the UE to reach  $P_{UMAX}$  level. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 2) for the UE Tx beam selection to complete.

1.5 SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition TxRx.

1.6 Measure the  $EVM_{\theta}$ ,  $EVM_{\phi}$ ,  $\overline{EVM}_{DMRS,\theta}$  and  $\overline{EVM}_{DMRS,\phi}$  using Global In-Channel Tx-Test (Annex E) for the  $\theta$ - and  $\phi$ -polarizations, respectively. For TDD, only slots consisting of only UL symbols are under test. Calculate  $\overline{EVM}_{DMRS} = \min(\overline{EVM}_{DMRS,\theta}, \overline{EVM}_{DMRS,\phi})$  and  $EVM = \min(EVM_{\theta}, EVM_{\phi})$ .

1.7 SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

NOTE1: When switching to DFT-s-OFDM waveform, as specified in Table 6.4.2.1.4.1-1, send an NR RRCReconfiguration message according to TS 38.508-1 [10] clause 4.6.3 Table 4.6.3-118 PUSCH-Config with TRANSFORM\_PRECODER\_ENABLED condition.

NOTE 2: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

**Table 6.4.2.1.4.2-1: Void**

**Table 6.4.2.1.4.2-2: Void**

**Table 6.4.2.1.4.2-3: Void**

Test procedure for PUCCH:

2.1 Retrieve the LO position from the parameter txDirectCurrentLocation in UplinkTxDirectCurrent IE.

2.2 PUCCH is set according to Table 6.4.2.1.4.1-2.

2.3 SS transmits PDSCH via PDCCH DCI format 1\_1 for C\_RNTI to transmit the DL RMC according to Table 6.4.2.1.4.1-2. The SS sends downlink MAC padding bits on the DL RMC. The transmission of PDSCH will make the UE send uplink ACK/NACK using PUCCH. There is no PUSCH transmission.

2.4 Set the UE in the Inband Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 2) for the UE Tx beam selection to complete.

2.5 SS send appropriate TPC commands for PUCCH to the UE until the UE transmit PUCCH at [P<sub>UMAX</sub> level]. Allow at least 200 ms starting from the first TPC command in this step for the UE to reach [P<sub>UMAX</sub> level]. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 2) for the UE Tx beam selection to complete.

2.6 SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition TxRx.

2.7 Measure PUCCH EVM<sub>θ</sub> and PUCCH EVM<sub>φ</sub> using Global In-Channel Tx-Test (Annex E). Calculate  $PUCCH\ EVM = \min(PUCCH\ EVM_{\theta}, PUCCH\ EVM_{\phi})$ .

2.8 SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

NOTE1: When switching to DFT-s-OFDM waveform, as specified in Table 6.4.2.1.4.1-2, send an NR RRCReconfiguration message according to TS 38.508-1 [10] clause 4.6.3 Table 4.6.3-118 PUSCH-Config with TRANSFORM\_PRECODER\_ENABLED condition.

NOTE 2: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

Test procedure for PRACH:

3.1 Retrieve the LO position from the parameter txDirectCurrentLocation in UplinkTxDirectCurrent IE.

3.2 Set the UE in the Inband Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1.

3.3 The SS shall set RS EPRE according to Table 6.4.2.1.4.1-3.

3.4 PRACH is set according to Table 6.4.2.1.4.1-3.

3.5 The SS shall signal a Random Access Preamble ID via a PDCCH order to the UE and initiate a Non-contention based Random Access procedure.

3.6 The UE shall send the signalled preamble to the SS.

3.7 In response to the preamble, the SS shall transmit a random access response not corresponding to the transmitted random access preamble, or send no response.

3.8 The UE shall consider the random access response reception not successful then re-transmit the preamble with the calculated PRACH transmission power.

3.9 Repeat step 3.5 and 3.6 until the SS collect enough PRACH preambles ([2] preambles for format 0 and [10] preambles for format 4). Measure the EVM<sub>θ</sub> and EVM<sub>φ</sub> in PRACH channel using Global In-Channel Tx-Test (Annex E). Calculate  $EVM = \min(EVM_{\theta}, EVM_{\phi})$ .

#### 6.4.2.1.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with the following exceptions for PRACH test.

**Table 6.4.2.1.4.3-1: RACH-ConfigGeneric for PRACH test**

Derivation Path: TS 38.508-1 [10], Table 4.6.3-130			
Information Element	Value/remark	Comment	Condition
RACH-ConfigGeneric ::= SEQUENCE {			
preambleReceivedTargetPower	-60		
powerRampingStep	dB0		
}			



**Table 6.4.2.1.4.3-2: ServingCellConfigCommon**

Derivation Path: TS 38.508-1 [10], Table 4.6.3-168			
Information Element	Value/remark	Comment	Condition
ServingCellConfigCommon ::= SEQUENCE {			
ss-PBCH-BlockPower	18		
}			

**Table 6.4.2.1.4.3-3: ServingCellConfigCommonSIB**

Derivation Path: TS 38.508-1 [10], Table 4.6.3-169			
Information Element	Value/remark	Comment	Condition
ServingCellConfigCommonSIB ::= SEQUENCE {			
ss-PBCH-BlockPower	18		
}			

#### 6.4.2.1.5 Test requirement

The PUSCH EVM, derived in Annex E.4.2, shall not exceed the values in Table 6.4.2.1.5-1.

The PUSCH  $\overline{EVM}_{DMRS}$ , derived in Annex E.4.6.2, shall not exceed the values in Table 6.4.2.1.5-1 when embedded with data symbols of the respective modulation scheme.

The PUCCH EVM derived in Annex E.5.9.2 shall not exceed the values for QPSK in Table 6.4.2.1.5-1.

The PRACH EVM derived in Annex E.6.9.2 shall not exceed the values for QPSK in Table 6.4.2.1.5-1.

**Table 6.4.2.1.5-1: Test requirements for Error Vector Magnitude**

Parameter	Unit	Average EVM Level	Reference Signal EVM Level
Pi/2 BPSK	%	30+TT	30+TT
QPSK	%	17.5+TT	17.5+TT
16 QAM	%	12.5+TT	12.5+TT
64 QAM	%	8+TT	8+TT

**Table 6.4.2.1.5-2: Test Tolerance (TT) for PUSCH, PC3, FR2a**

Test ID	Modulation	RB alloc.	50MHz	100MHz	200MHz	400MHz
1	DFT-s-OFDM Pi/2 BPSK	Inner_Full	0.00%	0.00%	0.00%	0.00%
2	DFT-s-OFDM Pi/2 BPSK	Outer_Full	0.00%	0.00%	0.00%	0.00%
3	DFT-s-OFDM QPSK	Inner_Full	0.00%	0.00%	0.00%	1.61%
4	DFT-s-OFDM QPSK	Outer_Full	0.00%	0.00%	0.00%	2.18%
5	DFT-s-OFDM 16 QAM	Inner_Full	0.00%	0.00%	1.53%	4.29%
6	DFT-s-OFDM 16 QAM	Outer_Full	0.00%	0.00%	1.67%	4.29%
7	DFT-s-OFDM 64 QAM	Inner_Full	1.06%	1.97%	3.61%	NA
8	DFT-s-OFDM 64 QAM	Outer_Full	1.44%	2.68%	NA	NA
9	CP-OFDM QPSK	Inner_Full	0.00%	0.00%	0.00%	3.66%
10	CP-OFDM QPSK	Outer_Full	0.00%	0.00%	1.37%	3.66%
11	CP-OFDM 16 QAM	Inner_Full	0.00%	1.35%	2.57%	NA
12	CP-OFDM 16 QAM	Outer_Full	0.00%	1.35%	2.57%	NA
13	CP-OFDM 64 QAM	Inner_Full	2.19%	3.97%	NA	NA
14	CP-OFDM 64 QAM	Outer_Full	2.19%	3.97%	NA	NA

NOTE 1: Test combinations without TT defined must be skipped as not testable.
---

**Table 6.4.2.1.5-3: Test Tolerance (TT) for PUSCH, PC3, FR2b**

Test ID	Modulation	RB alloc.	50MHz	100MHz	200MHz	400MHz
1	DFT-s-OFDM PI/2 BPSK	Inner_Full	0.00%	0.00%	0.00%	0.00%
2	DFT-s-OFDM PI/2 BPSK	Outer_Full	0.00%	0.00%	0.00%	2.50%
3	DFT-s-OFDM QPSK	Inner_Full	0.00%	0.00%	1.31%	2.49%
4	DFT-s-OFDM QPSK	Outer_Full	0.00%	0.00%	1.79%	4.01%
5	DFT-s-OFDM 16 QAM	Inner_Full	0.00%	1.48%	2.85%	NA
6	DFT-s-OFDM 16 QAM	Outer_Full	1.00%	1.92%	3.60%	NA
7	DFT-s-OFDM 64 QAM	Inner_Full	2.49%	NA	NA	NA
8	DFT-s-OFDM 64 QAM	Outer_Full	3.35%	NA	NA	NA
9	CP-OFDM QPSK	Inner_Full	0.00%	1.42%	2.73%	8.42%
10	CP-OFDM QPSK	Outer_Full	0.00%	1.58%	3.04%	8.42%
11	CP-OFDM 16 QAM	Inner_Full	1.72%	3.25%	5.92%	NA
12	CP-OFDM 16 QAM	Outer_Full	1.72%	3.25%	5.92%	NA
13	CP-OFDM 64 QAM	Inner_Full	NA	NA	NA	NA
14	CP-OFDM 64 QAM	Outer_Full	NA	NA	NA	NA

NOTE 1: Test combinations without TT defined must be skipped as not testable.

## 6.4.2.2 Carrier leakage

Editor's note: The following aspects are either missing or not yet determined:

- Measurement Uncertainty and Test Tolerance are FFS for power class 1, 2 and 4.
- The test case is incomplete for band n259.

### 6.4.2.2.1 Test purpose

Carrier leakage expresses itself as unmodulated sine wave with the carrier frequency. It is an interference of approximately constant amplitude and independent of the amplitude of the wanted signal. Carrier leakage interferes with the sub carriers at its position (if allocated), especially, when their amplitude is small.

The purpose of this test is to exercise the UE transmitter to verify its modulation quality in terms of carrier leakage.

### 6.4.2.2.2 Test applicability

This test case applies to all types of NR UE release 15 and forward.

### 6.4.2.2.3 Minimum conformance requirements

Carrier leakage is an additive sinusoid waveform. The carrier leakage requirement is defined for each component carrier. The measurement interval is one slot in the time domain. The relative carrier leakage power is a power ratio of the additive sinusoid waveform to the power in the modulated waveform.

The requirement is verified with the test metric of Carrier Leakage (Link=TX beam peak direction, Meas=Link angle).

When carrier leakage is contained inside the spectrum confined within the configured UL and DL CCs, the relative carrier leakage power shall not exceed the values specified in Table 6.4.2.2.3-1 for power class 1 UEs.

**Table 6.4.2.2.3-1: Minimum requirements for relative carrier leakage power for power class 1**

Parameters	Relative Limit (dBc)
$EIRP > 17 \text{ dBm}$	-25
$4 \text{ dBm} \leq EIRP \leq 17 \text{ dBm}$	-20

When carrier leakage is contained inside the spectrum occupied by the configured UL CCs and DL CCs, the relative carrier leakage power shall not exceed the values specified in Table 6.4.2.2.3-2 for power class 2.

**Table 6.4.2.2.3-2: Minimum requirements for relative carrier leakage power for power class 2**

Parameters	Relative Limit (dBc)
$EIRP > 6 \text{ dBm}$	-25
$-13 \text{ dBm} \leq EIRP \leq 6 \text{ dBm}$	-20

When carrier leakage is contained inside the spectrum occupied by the configured UL CCs and DL CCs, the relative carrier leakage power shall not exceed the values specified in Table 6.4.2.2.3-3 for power class 3 UEs.

**Table 6.4.2.2.3-3: Minimum requirements for relative carrier leakage power for power class 3**

Parameters	Relative Limit (dBc)
$EIRP > 0 \text{ dBm}$	-25
$-13 \text{ dBm} \leq EIRP \leq 0 \text{ dBm}$	-20

When carrier leakage is contained inside the spectrum occupied by the configured UL CCs and DL CCs, the relative carrier leakage power shall not exceed the values specified in Table 6.4.2.2.3-4 for power class 4.

**Table 6.4.2.2.3-4: Minimum requirements for relative carrier leakage power for power class 4**

Parameters	Relative Limit (dBc)
$EIRP > 11 \text{ dBm}$	-25
$-13 \text{ dBm} \leq EIRP \leq 11 \text{ dBm}$	-20

The normative reference for this requirement is TS 38.101-2[3] clause 6.4.2.2.

When carrier leakage is contained inside the spectrum occupied by the configured UL CCs and DL CCs, the relative carrier leakage power shall not exceed the values specified in Table 6.4.2.2.3-6 for power class 6.

**Table 6.4.2.2.3-6: Minimum requirements for relative carrier leakage power for power class 6**

Parameters	Relative Limit (dBc)
$EIRP > 7 \text{ dBm}$	-25
$-6 \text{ dBm} \leq EIRP \leq 7 \text{ dBm}$	-20

## 6.4.2.2.4 Test description

## 6.4.2.2.4.1 Initial condition

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, test channel bandwidths and sub-carrier spacing based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each combination of channel bandwidth and sub-carrier spacing, are shown in Table 6.4.2.2.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.4.2.2.4.1-1: Test Configuration**

Initial Conditions			
Test Environment as specified in TS 38.508-1 [10] subclause 4.1		Normal	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1		Low range, Mid range, High range	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1		Mid	
Test SCS as specified in Table 5.3.5-1		Highest	
Test Parameters			
Test ID	Downlink Configuration	Uplink Configuration	
		Modulation	RB allocation (NOTE 1, 3)
1	-	DFT-s-OFDM QPSK	Inner_Partial_Left for PC2, PC3, PC4 Inner_Partial_Left_Region2 for PC1
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.			
NOTE 2: Test Channel Bandwidths are checked separately for each NR band, which applicable channel bandwidths are specified in Table 5.3.5-1.			
NOTE 3: When the signalled DC carrier position is at Inner_Partial_Left for PC2, PC3, PC4, use Inner_Partial_Right for UL RB allocation. When the signalled DC carrier position is in Inner_Partial_Left_Region2 for PC1, use Inner_Partial_Right_Region2 for UL RB allocation.			

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, in Figure A.3.3.1.1 for TE diagram and section A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement channels are set according to Table 6.4.2.2.4.1-1.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.4.2.2.4.3.
7. In case the parameter 3300 or 3301 is reported from the UE via *txDirectCurrentLocation* IE, do not proceed to test procedure and mark the test not applicable with reasoning in the test report.

## 6.4.2.2.4.2 Test procedure

1. Retrieve the LO position from the parameter *txDirectCurrentLocation* in UplinkTxDirectCurrent IE.
2. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.4.2.2.4.1-1. Since the UE has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC.

3. Set the UE in the Inband Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
4. Send uplink power control commands to the UE using 1dB power step size to ensure that the UE  $EIRP_{Total} = EIRP_{\theta} + EIRP_{\phi}$  measured by the test system is within the Uplink power control window, defined as  $+MU$  to  $+(MU + \text{Uplink power control window size})$  dB of the target power level  $P_{req}$ , where:
  - $P_{req}$  is the power level specified in Table 6.4.2.2.4.2-1 according to the power class.
  - $MU$  is the test system uplink absolute power measurement uncertainty and is specified in Table F.1.2-1 under carrier leakage sub-clause for the carrier frequency  $f$  and the channel bandwidth  $BW$ .
  - Uplink power control window size = 1dB (UE power step size) + 5 dB (UE power step tolerance) + (Test system uplink relative power measurement uncertainty), where, the UE power step tolerance is specified in TS 38.101-1 [2], Table 6.3.4.3-1 and is 5dB for 1dB power step size, and the Test system uplink relative power measurement uncertainty is specified in Table F.1.2-1.

Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.

5. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition TxRx.
6. Measure carrier leakage using Global In-Channel Tx-Test (Annex E) for the  $\theta$ - and  $\phi$ -polarization at the LO position obtained in step 1. For TDD, only slots consisting of only UL symbols are under test. Calculate  $CarrLeak = \min(CarrLeak_{\theta}, CarrLeak_{\phi})$ .
7. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

NOTE 2: The purpose of the Uplink power control window is to ensure that the actual UE output power is no less than the target power level, and as close as possible to the target power level. The relationship between the Uplink power control window, the target power level and the corresponding possible actual UE Uplink power window is illustrated in Annex F.4.2.

**Table 6.4.2.2.4.2-1: UE EIRP  $P_{req}$  (dBm) for carrier leakage**

Power Class	$P_{req}$ (dBm) for step 3
Power Class 1	17
Power Class 2	6
Power Class 3	0
Power Class 4	11

**Table 6.4.2.2.4.2-2: Void.**

#### 6.4.2.2.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with TRANSFORM\_PRECODER\_ENABLED condition in Table 4.6.3-118 PUSCH-Config.

#### 6.4.2.2.5 Test requirement

For each of the  $n$  carrier leakage results derived in Annex E.3.1 for  $\theta$ - and  $\phi$ -polarization the minimum is calculated according to

$$CarrLeak = \min(CarrLeak_{\theta}, CarrLeak_{\phi}), \text{ where}$$

$$n = \begin{cases} 30, & \text{for 60 kHz SCS} \\ 60, & \text{for 120 kHz SCS} \end{cases}$$

Each of the  $n$  carrier leakage results CarrLeak shall not exceed the values in Table 6.4.2.2.5-1 to Table 6.4.2.2.5-4. Allocated RBs are not under test.

**Table 6.4.2.2.5-1a: Test requirements for relative carrier leakage power for power class 1**

Parameter	Relative limit (dBc)
17 dBm + MU < EIRP ≤ 17 dBm + MU + Uplink power control window size	-25 + TT

**Table 6.4.2.2.5-1b: Test Tolerance (carrier leakage for power class 1)**

Test Metric	FR2a	FR2b
Max device size ≤ 30 cm	TBD	TBD

**Table 6.4.2.2.5-2a: Test requirements for relative carrier leakage power for power class 2**

Parameter	Relative limit (dBc)
6 dBm + MU < EIRP ≤ 6 dBm + MU + Uplink power control window size	-25 + TT

**Table 6.4.2.2.5-2b: Test Tolerance (carrier leakage for power class 2)**

Test Metric	FR2a	FR2b
Max device size ≤ 30 cm	TBD	TBD

**Table 6.4.2.2.5-3a: Test requirements for relative carrier leakage power for power class 3**

Parameter	Relative limit (dBc)
0 dBm + MU < EIRP ≤ 0 dBm + MU + Uplink power control window size	-25 + TT

**Table 6.4.2.2.5-3b: Test Tolerance (carrier leakage for power class 3)**

Test Metric	FR2a	FR2b
Max device size ≤ 30 cm	3.54 dB	3.62 dB

**Table 6.4.2.2.5-4a: Test requirements for relative carrier Leakage Power for power class 4**

Parameter	Relative limit (dBc)
11 dBm + MU < EIRP ≤ 11 dBm + MU + Uplink power control window size	-25 + TT

**Table 6.4.2.2.5-4b: Test Tolerance (carrier leakage for power class 4)**

Test Metric	FR2a	FR2b
Max device size ≤ 30 cm	TBD	TBD

### 6.4.2.3 In-band emissions

**Editor’s note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- Measurement Uncertainty and Test Tolerance are FFS.
- Testing of the general in-band emission requirement and if yes at which UE Tx power level and with which relaxation applied to the requirement is FFS.

#### 6.4.2.3.1 Test purpose

The in-band emissions are a measure of the interference falling into the non-allocated resources blocks.

The purpose of this test is to exercise the UE transmitter to verify its modulation quality in terms of in-band emissions.

#### 6.4.2.3.2 Test applicability

This test case applies to all types of NR UE release 15 and forward.

#### 6.4.2.3.3 Minimum conformance requirements

The in-band emission is defined as the average across 12 sub-carriers and as a function of the RB offset from the edge of the allocated UL transmission bandwidth. The in-band emission is measured as the ratio of the UE output power in a non-allocated RB to the UE output power in an allocated RB. The IBE requirement does not apply if UE declares support for *mpr-PowerBoost-FR2-r16*, UL transmission is QPSK,  $MPR_{f,c} = 0$  and when NS\_200 applies, and the network configures the UE to operate with *mpr-PowerBoost-FR2-r16*.

The basic in-band emissions measurement interval is identical to that of the EVM test.

The requirement is verified with the test metric of In-band emission (Link=TX beam peak direction, Meas=Link angle).

The relative in-band emission shall not exceed the values specified in Table 6.4.2.3.3-1 for power class 1 UEs.

The average of the in-band emission measurement over 10 sub-frames shall not exceed the values specified in Table 6.4.2.3.3-1 for power class 1, Table 6.4.2.3.3-2 for power class 2, Table 6.4.2.3.3-3 for power class 3 and Table 6.4.2.3.3-4 for power class 4 UEs.

**Table 6.4.2.3.3-1: Requirements for in-band emissions for power class 1**

Parameter description	Unit	Limit (NOTE 1)		Applicable Frequencies
General	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10} (\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right]$		Any non-allocated (NOTE 2)
IQ Image	dB	-25	Output power > 27 dBm	Image frequencies (NOTES 2, 3)
		-20	Output power ≤ 27 dBm	
Carrier leakage	dBc	-25	Output power > 17 dBm	Carrier frequency (NOTES 4, 5)
		-20	4 dBm ≤ Output power ≤ 17 dBm	
<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB} - 25</math> dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 10.</p> <p>NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD</p> <p>NOTE 3: The applicable frequencies for this limit are those that are enclosed in the reflection of the allocated bandwidth, based on symmetry with respect to the carrier frequency, but excluding any allocated RBs.</p> <p>NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.</p> <p>NOTE 5: The applicable frequencies for this limit depend on the parameter <i>txDirectCurrentLocation</i> in</p>				

*UplinkTxDirectCurrent* IE, and are those that are enclosed in the RBs containing the DC frequency but excluding any allocated RB.

NOTE 6:  $L_{CRB}$  is the Transmission Bandwidth (see Section 5.3).

NOTE 7:  $N_{RB}$  is the Transmission Bandwidth Configuration (see Section 5.3).

NOTE 8: EVM is the limit for the modulation format used in the allocated RBs.

NOTE 9:  $\Delta_{RB}$  is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g.  $\Delta_{RB} = 1$  or  $\Delta_{RB} = -1$  for the first adjacent RB outside of the allocated bandwidth).

NOTE 10:  $P_{RB}$  is the transmitted power per allocated RB, measured in dBm.

NOTE 11: All powers are EIRP in beam peak direction.

The relative in-band emission shall not exceed the values specified in Table 6.4.2.3.3-2 for power class 2.

**Table 6.4.2.3.3-2: Requirements for in-band emissions for power class 2**

Parameter description	Unit	Limit (NOTE 1)		Applicable Frequencies
General	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10}(\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right]$		Any non-allocated (NOTE 2)
IQ Image	dB	-25	Output power > 16 dBm	Image frequencies (NOTES 2, 3)
		-20	Output power ≤ 16 dBm	
Carrier leakage	dBc	-25	Output power > 6 dBm	Carrier frequency (NOTES 4, 5)
		-20	-13 dBm ≤ Output power ≤ 6 dBm	
<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB} - 25</math> dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 10.</p> <p>NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD</p> <p>NOTE 3: The applicable frequencies for this limit are those that are enclosed in the reflection of the allocated bandwidth, based on symmetry with respect to the carrier frequency, but excluding any allocated RBs.</p> <p>NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.</p> <p>NOTE 5: The applicable frequencies for this limit depend on the parameter <i>txDirectCurrentLocation</i> in <i>UplinkTxDirectCurrent</i> IE, and are those that are enclosed in the RBs containing the DC frequency but excluding any allocated RB.</p> <p>NOTE 6: <math>L_{CRB}</math> is the Transmission Bandwidth (see Section 5.3).</p> <p>NOTE 7: <math>N_{RB}</math> is the Transmission Bandwidth Configuration (see Section 5.3).</p> <p>NOTE 8: EVM is the limit for the modulation format used in the allocated RBs.</p> <p>NOTE 9: <math>\Delta_{RB}</math> is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g. <math>\Delta_{RB} = 1</math> or <math>\Delta_{RB} = -1</math> for the first adjacent RB outside of the allocated bandwidth).</p> <p>NOTE 10: <math>P_{RB}</math> is the transmitted power per allocated RB, measured in dBm.</p> <p>NOTE 11: All powers are EIRP in beam peak direction.</p>				

The relative in-band emission shall not exceed the values specified in Table 6.4.2.3.3-3 for power class 3 UEs.

**Table 6.4.2.3.3-3: Requirements for in-band emissions for power class 3**

Parameter description	Unit	Limit (NOTE 1)		Applicable Frequencies
General	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10}(\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right]$		Any non-allocated (NOTE 2)
IQ Image	dB	-25	Output power > 10 dBm	Image frequencies (NOTES 2, 3)
		-20	Output power ≤ 10 dBm	



Carrier leakage	dBc	-25	Output power > 0 dBm	Carrier frequency (NOTES 4, 5)
		-20	-13 dBm ≤ Output power ≤ 0 dBm	
NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of ( $P_{RB} - 25$ dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. $P_{RB}$ is defined in NOTE 10.				
NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD				
NOTE 3: The applicable frequencies for this limit are those that are enclosed in the reflection of the allocated bandwidth, based on symmetry with respect to the carrier frequency, but excluding any allocated RBs.				
NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.				
NOTE 5: The applicable frequencies for this limit depend on the parameter <i>txDirectCurrentLocation</i> in <i>UplinkTxDirectCurrent</i> IE, and are those that are enclosed in the RBs containing the DC frequency but excluding any allocated RB.				
NOTE 6: $L_{CRB}$ is the Transmission Bandwidth (see Section 5.3).				
NOTE 7: $N_{RB}$ is the Transmission Bandwidth Configuration (see Section 5.3).				
NOTE 8: EVM s the limit for the modulation format used in the allocated RBs.				
NOTE 9: $\Delta_{RB}$ is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g. $\Delta_{RB} = 1$ or $\Delta_{RB} = -1$ for the first adjacent RB outside of the allocated bandwidth).				
NOTE 10: $P_{RB}$ is the transmitted power per allocated RB, measured in dBm.				
NOTE 11: All powers are EIRP in beam peak direction.				

The relative in-band emission shall not exceed the values specified in Table 6.4.2.3.3-4 for power class 4 UEs.

**Table 6.4.2.3.3-4: Requirements for in-band emissions for power class 4**

Parameter description	Unit	Limit (NOTE 1)		Applicable Frequencies
General	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10}(\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right]$		Any non-allocated (NOTE 2)
IQ Image	dB	-25	Output power > 21 dBm	Image frequencies (NOTES 2, 3)
		-20	Output power ≤ 21 dBm	
Carrier leakage	dBc	-25	Output power > 11 dBm	Carrier frequency (NOTES 4, 5)
		-20	-13 dBm ≤ Output power ≤ 11 dBm	
NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of ( $P_{RB} - 25$ dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. $P_{RB}$ is defined in NOTE 10.				
NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD				
NOTE 3: The applicable frequencies for this limit are those that are enclosed in the reflection of the allocated bandwidth, based on symmetry with respect to the carrier frequency, but excluding any allocated RBs.				
NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.				
NOTE 5: The applicable frequencies for this limit depend on the parameter <i>txDirectCurrentLocation</i> in <i>UplinkTxDirectCurrent</i> IE, and are those that are enclosed in the RBs containing the DC frequency but excluding any allocated RB.				
NOTE 6: $L_{CRB}$ is the Transmission Bandwidth (see Section 5.3).				
NOTE 7: $N_{RB}$ is the Transmission Bandwidth Configuration (see Section 5.3).				
NOTE 8: EVM s the limit for the modulation format used in the allocated RBs.				
NOTE 9: $\Delta_{RB}$ is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g. $\Delta_{RB} = 1$ or				

$\Delta_{RB} = -1$  for the first adjacent RB outside of the allocated bandwidth).  
 NOTE 10:  $P_{RB}$  is the transmitted power per allocated RB, measured in dBm.  
 NOTE 11: All powers are EIRP in beam peak direction.

The normative reference for this requirement is TS 38.101-2 [3] clause 6.4.2.3.

The average of the in-band emission measurement over 10 sub-frames shall not exceed the values specified in Table 6.4.2.3.3-6 for power class 6 UEs.

**Table 6.4.2.3.3-6: Requirements for in-band emissions for power class 6**

Parameter description	Unit	Limit (NOTE 1)		Applicable Frequencies
General	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right) \\ 20 \cdot \log_{10}(\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}} \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right]$		Any non-allocated (NOTE 2)
IQ Image	dB	-25	Output power > 17 dBm	Image frequencies (NOTES 2, 3)
		-20	Output power ≤ 17 dBm	
Carrier leakage	dBc	-25	Output power > 7 dBm	Carrier frequency (NOTES 4, 5)
		-20	-6 dBm ≤ Output power ≤ 7 dBm	

NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of ( $\overline{P_{RB}} - 25$  dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply.  $\overline{P_{RB}}$  is defined in NOTE 10.

NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For Pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD

NOTE 3: The applicable frequencies for this limit are those that are enclosed in the reflection of the allocated bandwidth, based on symmetry with respect to the carrier frequency, but excluding any allocated RBs.

NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.

NOTE 5: The applicable frequencies for this limit depend on the parameter *txDirectCurrentLocation* in *UplinkTxDirectCurrent* IE, and are those that are enclosed in the RBs containing the DC frequency but excluding any allocated RB.

NOTE 6:  $L_{CRB}$  is the Transmission Bandwidth (see Clause 5.3).

NOTE 7:  $N_{RB}$  is the Transmission Bandwidth Configuration (see Clause 5.3).

NOTE 8: EVM is the limit for the modulation format used in the allocated RBs.

NOTE 9:  $\Delta_{RB}$  is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g.  $\Delta_{RB} = 1$  or  $\Delta_{RB} = -1$  for the first adjacent RB outside of the allocated bandwidth).

NOTE 10:  $\overline{P_{RB}}$  is an average of the transmitted power over 10 sub-frames normalized by the number of allocated RBs, measured in dBm.

NOTE 11: All powers are EIRP in beam peak direction.

6.4.2.3.4 Test description

6.4.2.3.4.1 Initial condition

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, test channel bandwidths and sub-carrier spacing based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each combination of channel bandwidth and sub-carrier spacing, are shown in Table 6.4.2.3.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annex A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.4.2.3.4.1-1: Test Configuration Table for PUSCH**

Initial Conditions			
Test Environment as specified in TS 38.508-1 [10] subclause 4.1		Normal	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1		Low range, Mid range, High range	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1		Lowest, Mid, Highest	
Test SCS as specified in Table 5.3.5-1		Lowest	
Test Parameters			
Test ID	Downlink Configuration	Uplink Configuration	
		Modulation	RB allocation (NOTE 1)
1		DFT-s-OFDM PI/2 BPSK	Inner_Partial_Left for PC2, PC3, PC4 Inner_Partial_Left_Region2 for PC1
2		DFT-s-OFDM PI/2 BPSK	Inner_Partial_Right for PC2, PC3, PC4 Inner_Partial_Right_Region2 for PC1
3		CP-OFDM QPSK	Inner_Partial_Left for PC2, PC3, PC4 Inner_Partial_Left_Region2 for PC1
4		CP-OFDM QPSK	Inner_Partial_Right for PC2, PC3, PC4 Inner_Partial_Right_Region2 for PC1
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.			
NOTE 2: Test Channel Bandwidths are checked separately for each NR band, which applicable channel bandwidths are specified in Table 5.3.5-1.			

**Table 6.4.2.3.4.1-2: Test Configuration Table for PUCCH**

Initial Conditions				
Test Environment as specified in TS 38.508-1 [10] subclause 4.1		See Table 6.4.2.3.4.1-1		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1		See Table 6.4.2.3.4.1-1		
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1		See Table 6.4.2.3.4.1-1		
Test SCS as specified in Table 5.3.5-1		See Table 6.4.2.3.4.1-1		
Test Parameters				
ID	Downlink Configuration		Uplink Configuration	
	Modulation	RB allocation	Waveform	PUCCH format
1	CP-OFDM QPSK	Full RB (Note 1)	CP-OFDM	PUCCH format = Format 1 Length in OFDM symbols = 14
2	CP-OFDM QPSK	Full RB (Note 1)	DFT-s-OFDM	PUCCH format = Format 3 Length in OFDM symbols = 14
NOTE 1: Full RB allocation shall be used per each SCS and channel BW as specified in Table 7.3.2.4.1-2.				
NOTE 2: Test Channel Bandwidths are checked separately for each NR band, which applicable channel bandwidths are specified in Table 5.3.5-1.				

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, in Figure A.3.3.1.1 for TE diagram and section A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.

3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement channels are set according to Table 6.4.2.3.4.1-1.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.4.2.3.4.3

#### 6.4.2.3.4.2 Test procedure

Test procedure for PUSCH:

1.1 Retrieve the LO position from the parameter txDirectCurrentLocation in UplinkTxDirectCurrent IE.

1.2 SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.4.2.3.4.1-1. Since the UE has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC.

1.3 Set the UE in the Inband Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 2) for the UE Tx beam selection to complete.

1.4 Send the appropriate TPC commands in the uplink scheduling information to the UE until UE output power is  $P_{req} + P_W \pm P_W$ , where  $P_{req}$  is the power level specified in Tables 6.4.2.3.4.2-1 according to the power class with power ID = 1.  $P_W$  is the power window according to Table 6.4.2.3.4.2-2 for the carrier frequency  $f$  and the channel bandwidth  $BW$ . Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 2) for the UE Tx beam selection to complete.

1.5 SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition TxRx.

1.6 Measure In-band emission  $IE_\theta$ ,  $IE_\phi$  using Global In-Channel Tx-Test (Annex E) for the  $\theta$ - and  $\phi$ -polarizations, respectively. For TDD, only slots consisting of only UL symbols are under test. Calculate  $IE = IE_\theta + IE_\phi$ , where the calculation is based on linear power ratios.

1.7 SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

1.8 Repeat steps 1.3 through 1.6 until In-band emissions have been measured for all power IDs in Table 6.4.2.3.4.2-1.

NOTE 1: When switching to DFT-s-OFDM waveform, as specified in Table 6.4.2.3.4.1-1, send an NR RRCReconfiguration message according to TS 38.508-1 [10] clause 4.6.3 Table 4.6.3-118 PUSCH-Config with TRANSFORM\_PRECODER\_ENABLED condition.

NOTE 2: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

**Table 6.4.2.3.4.2-1: Parameters for In-band emissions**

Power ID	Unit	Level for power class 1	Level for power class 2	Level for power class 3	Level for power class 4
1	dBm	27	16	10	21
2	dBm	17	6	0	11

**Table 6.4.2.3.4.2-2: Power Window (dB) for In-band emissions PUSCH and PUCCH**

TBD

Test procedure for PUCCH:

2.1 Retrieve the LO position from the parameter txDirectCurrentLocation in UplinkTxDirectCurrent IE.

- 2.2 PUCCH is set according to Table 6.4.2.3.4.1-2. SS transmits PDSCH via PDCCH DCI format 1\_1 for C\_RNTI to transmit the DL RMC according to Table 6.4.2.3.4.1-2. The SS sends downlink MAC padding bits on the DL RMC. The transmission of PDSCH will make the UE send uplink ACK/NACK using PUCCH.
- 2.3 Set the UE in the Inband Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
- 2.4 Send the appropriate TPC commands in the uplink scheduling information for PUCCH to the UE until UE output power is  $P_{req} + P_W \pm P_W$ , where  $P_{req}$  is the power level specified in Tables 6.4.2.3.4.2-1 according to the power class with power ID = 1.  $P_W$  is the power window according to Table 6.4.2.3.4.2-2 for the carrier frequency  $f$  and the channel bandwidth  $BW$ . Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
- 2.5 SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition TxRx.
- 2.6 Measure In-band emission  $IE_\theta$ ,  $IE_\phi$  using Global In-Channel Tx-Test (Annex E) for the  $\theta$ - and  $\phi$ -polarizations, respectively. Calculate  $IE = IE_\theta + IE_\phi$ , where the calculation is based on linear power ratios.
- 2.7 SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.
- 2.8 Repeat steps 2.3 through 2.6 until In-band emissions have been measured for all power IDs in Table 6.4.2.3.4.2-1.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

NOTE 2: When switching to DFT-s-OFDM waveform, as specified in Table 6.4.2.3.4.1-1, send an NR RRCReconfiguration message according to TS 38.508-1 [10] clause 4.6.3 Table 4.6.3-118 PUSCH-Config with TRANSFORM\_PRECODER\_ENABLED condition.

6.4.2.3.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6.

6.4.2.3.5 Test requirement

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4.2.3.5-1 for power class 1 UEs.

**Table 6.4.2.3.5-1: Test requirements for in-band emissions for power class 1**

Parameter description	Unit	Limit (NOTE 1)		Applicable Frequencies
General (NOTE 12)	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{AR}}{L_{CRF}} \right), \\ 20 \cdot \log_{10} (EVM) - 5 \cdot \frac{(\Delta_{RB} - 1)}{L_{CRF}}, \\ -55.1 \text{ dBm} - P_{PR} \end{array} \right] + TT$		Any non-allocated (NOTE 2)
IQ Image (NOTE 12)	dB	-25+TT	Output power > 27 dBm	Image frequencies (NOTES 2, 3)
		-20+TT	Output power ≤ 27 dBm	
Carrier leakage (NOTE 12)	dBc	-25+TT	Output power > 17 dBm	Carrier frequency (NOTES 4, 5)
		-20+TT	4 dBm ≤ Output power ≤ 17 dBm	
<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB} - 25</math> dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 10.</p> <p>NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD</p> <p>NOTE 3: The applicable frequencies for this limit are those that are enclosed in the reflection of the allocated bandwidth, based on symmetry with respect to the carrier frequency, but excluding any allocated RBs.</p>				

NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.

NOTE 5: The applicable frequencies for this limit depend on the parameter *txDirectCurrentLocation* in *UplinkTxDirectCurrent* IE, and are those that are enclosed in the RBs containing the DC but excluding any allocated RB.

NOTE 6:  $L_{CRB}$  is the Transmission Bandwidth (see Section 5.3).

NOTE 7:  $N_{RB}$  is the Transmission Bandwidth Configuration (see Section 5.3).

NOTE 8: EVM is the limit for the modulation format used in the allocated RBs.

NOTE 9:  $\Delta_{RB}$  is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g.  $\Delta_{RB}= 1$  or  $\Delta_{RB}= -1$  for the first adjacent RB outside of the allocated bandwidth).

NOTE 10:  $P_{RB}$  is the transmitted power per allocated RB, measured in dBm.

NOTE 11: All powers are EIRP in beam peak direction.

NOTE 12: In case the parameter 3300 or 3301 is reported from UE via *txDirectCurrentLocation* IE, IQ Image and Carrier leakage limit do not apply and General limit applies for all non-allocated frequencies.

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4.2.3.5-2 for power class 2 UEs.

**Table 6.4.2.3.5-2: Test requirements for in-band emissions for power class 2**

Parameter description	Unit	Limit (NOTE 1)		Applicable Frequencies
General (NOTE 12)	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10} (\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right] + TT$		Any non-allocated (NOTE 2)
IQ Image (NOTE 12)	dB	-25 + TT	Output power > 16 dBm	Image frequencies (NOTES 2, 3)
		-20 + TT	Output power ≤ 16 dBm	
Carrier leakage (NOTE 12)	dBc	-25 + TT	Output power > 6 dBm	Carrier frequency (NOTES 4, 5)
		-20 + TT	-13 dBm ≤ Output power ≤ 6 dBm	
<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB} - 25</math> dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 10.</p> <p>NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD</p> <p>NOTE 3: The applicable frequencies for this limit are those that are enclosed in the reflection of the allocated bandwidth, based on symmetry with respect to the carrier frequency, but excluding any allocated RBs.</p> <p>NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.</p> <p>NOTE 5: The applicable frequencies for this limit depend on the parameter <i>txDirectCurrentLocation</i> in <i>UplinkTxDirectCurrent</i> IE, and are those that are enclosed in the RBs containing the DC frequency if <math>N_{RB}</math> is odd, or in the two RBs immediately adjacent to the DC frequency if <math>N_{RB}</math> is even but excluding any allocated RB.</p> <p>NOTE 6: <math>L_{CRB}</math> is the Transmission Bandwidth (see Section 5.3).</p> <p>NOTE 7: <math>N_{RB}</math> is the Transmission Bandwidth Configuration (see Section 5.3).</p> <p>NOTE 8: EVM is the limit for the modulation format used in the allocated RBs.</p> <p>NOTE 9: <math>\Delta_{RB}</math> is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g. <math>\Delta_{RB}= 1</math> or <math>\Delta_{RB}= -1</math> for the first adjacent RB outside of the allocated bandwidth).</p> <p>NOTE 10: <math>P_{RB}</math> is the transmitted power per allocated RB, measured in dBm.</p> <p>NOTE 11: All powers are EIRP in beam peak direction.</p> <p>NOTE 12: In case the parameter 3300 or 3301 is reported from UE via <i>txDirectCurrentLocation</i> IE, IQ Image and Carrier leakage limit do not apply and General limit applies for all non-allocated frequencies.</p>				

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4.2.3.5-3 for power class 3 UEs.

**Table 6.4.2.3.5-3: Requirements for in-band emissions for power class 3**

Parameter description	Unit	Limit (NOTE 1)		Applicable Frequencies
General (NOTE 12)	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10}(\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right] + TT$		Any non-allocated (NOTE 2)
IQ Image (NOTE 12)	dB	-25+TT	Output power > 10 dBm	Image frequencies (NOTES 2, 3)
		-20+TT	Output power ≤ 10 dBm	
Carrier leakage (NOTE 12)	dBc	-25+TT	Output power > 0 dBm	Carrier frequency (NOTES 4, 5)
		-20+TT	-13 dBm ≤ Output power ≤ 0 dBm	
<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB} - 25</math> dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 10.</p> <p>NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD.</p> <p>NOTE 3: The applicable frequencies for this limit are those that are enclosed in the reflection of the allocated bandwidth, based on symmetry with respect to the carrier frequency, but excluding any allocated RBs.</p> <p>NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.</p> <p>NOTE 5: The applicable frequencies for this limit depend on the parameter <i>txDirectCurrentLocation</i> in <i>UplinkTxDirectCurrent</i> IE, and are those that are enclosed in the RBs containing the DC but excluding any allocated RB.</p> <p>NOTE 6: <math>L_{CRB}</math> is the Transmission Bandwidth (see Section 5.3).</p> <p>NOTE 7: <math>N_{RB}</math> is the Transmission Bandwidth Configuration (see Section 5.3).</p> <p>NOTE 8: EVM is the limit for the modulation format used in the allocated RBs.</p> <p>NOTE 9: <math>\Delta_{RB}</math> is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g. <math>\Delta_{RB} = 1</math> or <math>\Delta_{RB} = -1</math> for the first adjacent RB outside of the allocated bandwidth).</p> <p>NOTE 10: <math>P_{RB}</math> is the transmitted power per allocated RB, measured in dBm.</p> <p>NOTE 11: All powers are EIRP in beam peak direction.</p> <p>NOTE 12: In case the parameter 3300 or 3301 is reported from UE via <i>txDirectCurrentLocation</i> IE, IQ Image and Carrier leakage limit do not apply and General limit applies for all non-allocated frequencies.</p>				

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4.2.3.5-4 for power class 4 UEs.

**Table 6.4.2.3.5-4: Test requirements for in-band emissions for power class 4**

Parameter description	Unit	Limit (NOTE 1)		Applicable Frequencies
General (NOTE 12)	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10}(\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right] + TT$		Any non-allocated (NOTE 2)
IQ Image (NOTE 12)	dB	-25 + TT	Output power > 21 dBm	Image frequencies (NOTES 2, 3)
		-20 + TT	Output power ≤ 21 dBm	
Carrier leakage (NOTE 12)	dBc	-25 + TT	Output power > 11 dBm	Carrier frequency (NOTES 4, 5)
		-20 + TT	-13 dBm ≤ Output power ≤ 11 dBm	

- NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of ( $P_{RB} - 25$  dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply.  $P_{RB}$  is defined in NOTE 10.
- NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD
- NOTE 3: The applicable frequencies for this limit are those that are enclosed in the reflection of the allocated bandwidth, based on symmetry with respect to the carrier frequency, but excluding any allocated RBs.
- NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.
- NOTE 5: The applicable frequencies for this limit depend on the parameter *txDirectCurrentLocation* in *UplinkTxDirectCurrent* IE, and are those that are enclosed in the RBs containing the DC frequency but excluding any allocated RB.
- NOTE 6:  $L_{CRB}$  is the Transmission Bandwidth (see Section 5.3).
- NOTE 7:  $N_{RB}$  is the Transmission Bandwidth Configuration (see Section 5.3).
- NOTE 8: EVM is the limit for the modulation format used in the allocated RBs.
- NOTE 9:  $\Delta_{RB}$  is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g.  $\Delta_{RB} = 1$  or  $\Delta_{RB} = -1$  for the first adjacent RB outside of the allocated bandwidth).
- NOTE 10:  $P_{RB}$  is the transmitted power per allocated RB, measured in dBm.
- NOTE 11: All powers are EIRP in beam peak direction.
- NOTE 12: In case the parameter 3300 or 3301 is reported from UE via *txDirectCurrentLocation* IE, IQ Image and Carrier leakage limit do not apply and General limit applies for all non-allocated frequencies.

#### 6.4.2.4 EVM equalizer spectrum flatness

Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:

- Measurement Uncertainty and Test Tolerance are FFS.

##### 6.4.2.4.1 Test purpose

The zero-forcing equalizer correction applied in the EVM measurement process (as described in Annex E) must meet a spectral flatness requirement for the EVM measurement to be valid. The EVM equalizer spectrum flatness is defined in terms of the maximum peak-to-peak ripple of the equalizer coefficients (dB) across the allocated uplink block, at which the equalizer coefficients are generated by the EVM measurement process. The basic measurement interval is the same as for EVM.

The EVM equalizer spectrum flatness requirement does not limit the correction applied to the signal in the EVM measurement process but for the EVM result to be valid, the equalizer correction that was applied must meet the EVM equalizer spectrum flatness minimum requirements.

##### 6.4.2.4.2 Test applicability

This test case applies to all types of NR UE release 15 and forward.

##### 6.4.2.4.3 Minimum conformance requirements

For pi/2 BPSK modulation, the minimum requirements are defined in Clause 6.4.2.5.3.

The peak-to-peak variation of the EVM equalizer coefficients contained within the frequency range of the uplink allocation shall not exceed the maximum ripple specified in Table 6.4.2.4.3-1 for normal conditions. For uplink allocations contained within both Range 1 and Range 2, the coefficients evaluated within each of these frequency ranges shall meet the corresponding ripple requirement and the following additional requirements: the relative difference between the maximum coefficient in Range 1 and the minimum coefficient in Range 2 (Table 6.4.2.4.3-1) must not be larger than 7 dB, and the relative difference between the maximum coefficient in Range 2 and the minimum coefficient in Range 1 must not be larger than 8 dB (see Figure 6.4.2.4.3-1).

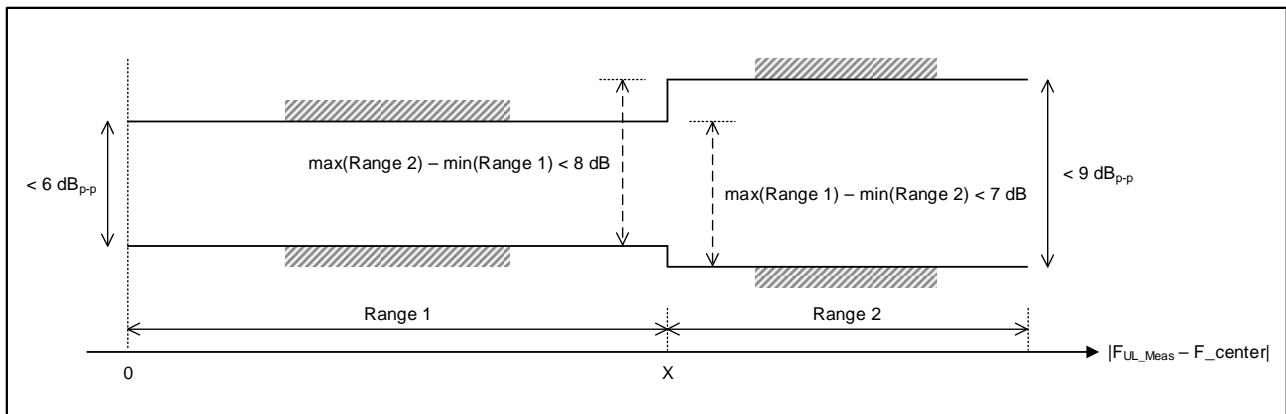


The requirement is verified with the test metric of EVM SF (Link=TX beam peak direction, Meas=Link angle).

**Table 6.4.2.4.3-1: Minimum requirements for EVM equalizer spectrum flatness (normal conditions)**

Frequency range	Maximum ripple (dB)
$ F_{UL\_Meas} - F_{center}  \leq X$ MHz (Range 1)	6 (p-p)
$ F_{UL\_Meas} - F_{center}  > X$ MHz (Range 2)	9 (p-p)

NOTE 1:  $F_{UL\_Meas}$  refers to the sub-carrier frequency for which the equalizer coefficient is evaluated  
 NOTE 2:  $F_{center}$  refers to the centre frequency of the CC  
 NOTE 3: X, in MHz, is equal to 30% of the CC bandwidth



**Figure 6.4.2.4.3-1: The limits for EVM equalizer spectral flatness with the maximum allowed variation of the coefficients indicated under normal conditions**

The normative reference for this requirement is TS 38.101-2 [3] clause 6.4.2.4.

6.4.2.4.4 Test description

6.4.2.4.4.1 Initial condition

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, test channel bandwidths and sub-carrier spacing based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each combination of channel bandwidth and sub-carrier spacing, are shown in Table 6.4.2.4.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annex A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.4.2.4.4.1-1: Test Configuration**

Initial Conditions			
Test Environment as specified in TS 38.508-1 [10] subclause 4.1		Normal	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1		Low range, Mid range, High range	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1		Lowest, Mid, Highest	
Test SCS as specified in Table 5.3.5-1		Lowest	
Test Parameters			
Test ID	Downlink Configuration	Uplink Configuration	
	-	Modulation	RB allocation (NOTE 1)

1		DFT-s-OFDM QPSK	Outer_Full
2		CP-OFDM QPSK	Outer_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.			
NOTE 2: Test Channel Bandwidths are checked separately for each NR band, which applicable channel bandwidths are specified in Table 5.3.5-1.			

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, in Figure A.3.3.1.1 for TE diagram and section A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement channels are set according to Table 6.4.2.4.4.1-1.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.4.2.4.4.3

#### 6.4.2.4.4.2 Test procedure

1. Retrieve the LO position from the parameter txDirectCurrentLocation in UplinkTxDirectCurrent IE.
2. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.4.2.4.4.1-1. Since the UE has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC
3. Set the UE in the Inband Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 2) for the UE Tx beam selection to complete.
4. Send continuously uplink power control "up" commands in the uplink scheduling information to the UE until the UE transmits at  $P_{UMAX}$  level. Allow at least 200 ms for the UE to reach  $P_{UMAX}$  level. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 2) for the UE Tx beam selection to complete.
5. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition TxRx.
6. Measure spectrum flatness using Global In-Channel Tx-Test (Annex E) for the  $\theta$ - and  $\phi$ -polarizations, respectively. For TDD, only slots consisting of only UL symbols are under test.
7. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

NOTE1: When switching to DFT-s-OFDM waveform, as specified in Table 6.4.2.4.4.1-1, send an NR RRCReconfiguration message according to TS 38.508-1 [10] clause 4.6.3 Table 4.6.3-118 PUSCH-Config with TRANSFORM\_PRECODER\_ENABLED condition.

NOTE 2: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

#### 6.4.2.4.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6.

#### 6.4.2.4.5 Test requirement

Each of the  $n$  spectrum flatness functions, shall derive four ripple results in Annex E.4.4. The derived results shall not exceed the values in Figure 6.4.2.4.5-1: The peak-to-peak variation of the EVM equalizer coefficients contained within the frequency range of the uplink allocation shall not exceed the maximum ripple specified in Table 6.4.2.4.5-1 for normal conditions. For uplink allocations contained within both Range 1 and Range 2, the coefficients evaluated within each of these frequency ranges shall meet the corresponding ripple requirement and the following additional

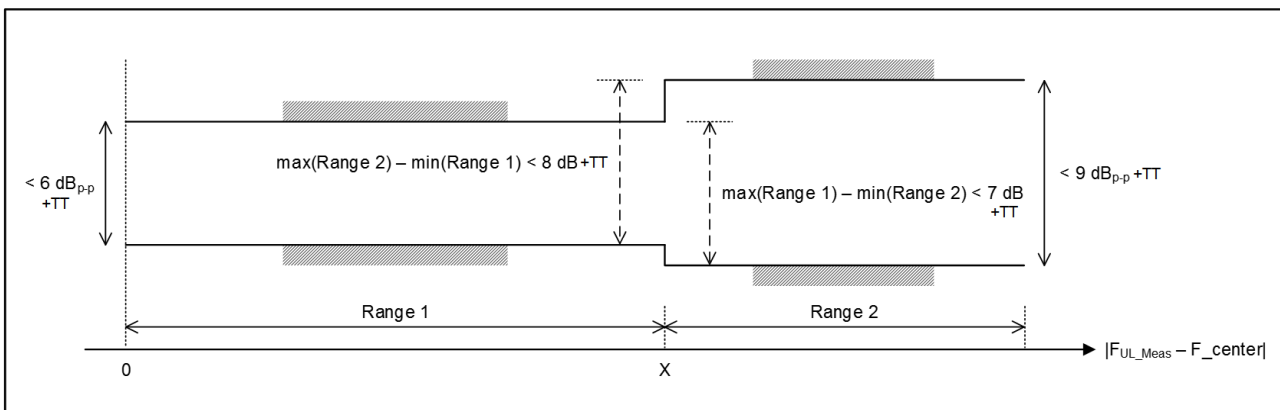
requirements: the relative difference between the maximum coefficient in Range 1 and the minimum coefficient in Range 2 (Table 6.4.2.4.5-1) must not be larger than 7 dB + TT, and the relative difference between the maximum coefficient in Range 2 and the minimum coefficient in Range 1 must not be larger than 8 dB + TT (see Figure 6.4.2.4.5-1).

The UE passes the test when the derived results for at least one polarization fulfil the test requirements.

**Table 6.4.2.4.5-1: Test requirements for EVM equalizer spectrum flatness (normal conditions)**

Frequency range	Maximum ripple (dB)
$ F_{UL\_Meas} - F_{center}  \leq X$ MHz (Range 1)	6 + TT (p-p)
$ F_{UL\_Meas} - F_{center}  > X$ MHz (Range 2)	9 + TT (p-p)

NOTE 1:  $F_{UL\_Meas}$  refers to the sub-carrier frequency for which the equalizer coefficient is evaluated  
 NOTE 2:  $F_{center}$  refers to the centre frequency of the CC  
 NOTE 3: X, in MHz, is equal to 30% of the CC bandwidth



**Figure 6.4.2.4.5-1: The limits for EVM equalizer spectral flatness with the maximum allowed variation of the coefficients indicated under normal conditions**

6.4.2.5 EVM spectral flatness for pi/2 BPSK modulation

Editor’s note: This clause is incomplete. The following aspects are either missing or not yet determined:

- Measurement Uncertainty and Test Tolerance are FFS.
- Whether and, if yes, how to test the requirement on shaping filter is FFS.

6.4.2.5.1 Test purpose

Same test purpose as in clause 6.4.2.4.1.

6.4.2.5.2 Test applicability

This test case applies to all types of NR FR2 UE release 15 and forward supporting pi/2 BPSK modulation.

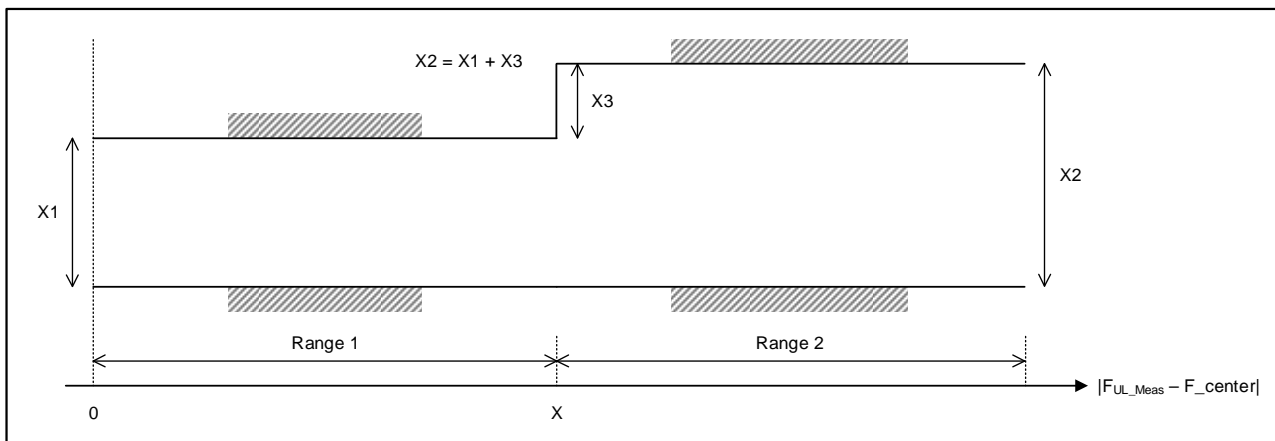
6.4.2.5.3 Minimum conformance requirements

These requirements are defined for pi/2 BPSK modulation. The EVM equalizer coefficients across the allocated uplink block shall be modified to fit inside the mask specified in Table 6.4.2.5.3-1 for normal conditions, prior to the calculation of EVM. The limiting mask shall be placed to minimize the change in equalizer coefficients in a sum of squares sense.

**Table 6.4.2.5.3-1: Mask for EVM equalizer coefficients for pi/2 BPSK (normal conditions)**

Frequency range	Parameter	Maximum ripple (dB)
$ F_{UL\_Meas} - F_{center}  \leq X$ MHz (Range 1)	X1	6 (p-p)
$ F_{UL\_Meas} - F_{center}  > X$ MHz (Range 2)	X2	14 (p-p)

NOTE 1:  $F_{UL\_Meas}$  refers to the sub-carrier frequency for which the equalizer coefficient is evaluated.  
 NOTE 2:  $F_{center}$  refers to the centre frequency of an allocated block of PRBs.  
 NOTE 3: X, in MHz, is equal to 25% of the bandwidth of the PRB allocation.  
 NOTE 4: See Figure 6.4.2.5.3-1 for description of X1, X2 and X3.



**Figure 6.4.2.5.3-1: The limits for EVM equalizer spectral flatness with the maximum allowed variation.  $F_{center}$  denotes the centre frequency of the allocated block of PRBs.  $F_{alloc}$  denotes the bandwidth of the PRB allocation**

This requirement does not apply to other modulation types. The UE shall be allowed to employ spectral shaping for pi/2 BPSK. The shaping filter shall be restricted so that the impulse response of the transmit chain shall meet

$$|\tilde{a}_i(t,0)| \geq |\tilde{a}_i(t,\tau)| \quad \forall \tau \neq 0$$

$$20\log_{10} |\tilde{a}_i(t,\tau)| < -15 \text{ dB} \quad 1 < \tau < M - 1,$$

Where:

$$|\tilde{a}_i(t,\tau)| = \text{IDFT}\{ |\tilde{a}_i(t,f)| e^{j\varphi(t,f)} \},$$

f is the frequency of the M allocated subcarriers,

$\tilde{a}_i(t,f)$  and  $\varphi(t,f)$  are the amplitude and phase response, respectively of the transmit chain

0dB reference is defined as  $20\log_{10} |\tilde{a}_i(t,0)|$

The normative reference for this requirement is TS 38.101-2 [3] clause 6.4.2.5.

**6.4.2.5.4 Test description**

**6.4.2.5.4.1 Initial condition**

Same initial conditions as in clause 6.4.2.4.4.1 with following exceptions:

- Instead of Table 6.4.2.4.4.1-1 → use Table 6.4.2.5.4.1-1

**Table 6.4.2.5.4.1-1: Test Configuration**

Initial Conditions			
Test Environment as specified in TS 38.508-1 [10] subclause 4.1		Normal	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1		Low range, Mid range, High range	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1		Lowest, Mid, Highest	
Test SCS as specified in TS 38.508-1 [10] subclause 5.3.5-1		Lowest	
Test Parameters			
Test ID	Downlink Configuration	Uplink Configuration	
		Modulation	RB allocation (NOTE 1)
1	-	DFT-s-OFDM pi/2-BPSK	Outer_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.			
NOTE 2: Test Channel Bandwidths are checked separately for each NR band, which applicable channel bandwidths are specified in Table 5.3.5-1.			

#### 6.4.2.5.4.2 Test procedure

1. Retrieve the LO position from the parameter txDirectCurrentLocation in UplinkTxDirectCurrent IE.
2. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.4.2.5.4.1-1. Since the UE has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC
3. Set the UE in the Inband Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
4. Send continuously uplink power control "up" commands in the uplink scheduling information to the UE until the UE transmits at P<sub>UMAX</sub> level. Allow at least 200 ms for the UE to reach P<sub>UMAX</sub> level. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
5. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition TxRx.
6. Measure spectrum flatness using Global In-Channel Tx-Test (Annex E) for the  $\theta$ - and  $\phi$ -polarizations, respectively. For TDD, only slots consisting of only UL symbols are under test.
7. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

#### 6.4.2.5.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with TRANSFORM\_PRECODER\_ENABLED condition in Table 4.6.3-118 PUSCH-Config.

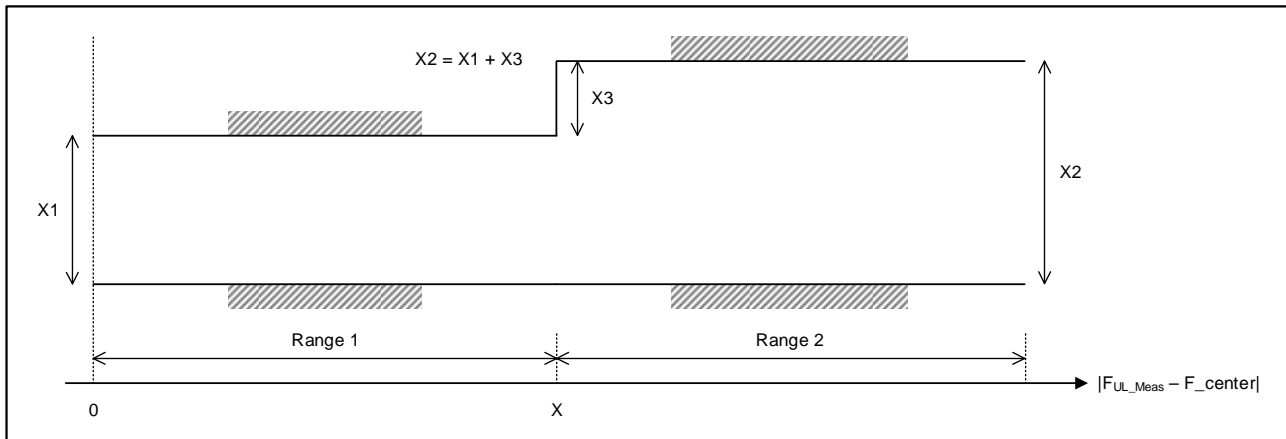
#### 6.4.2.5.5 Test requirement

Each of the  $n$  spectrum flatness functions, shall derive four ripple results in Annex E.4.4. The derived results shall not exceed the values in Table 6.4.2.5.5-1 and Figure 6.4.2.5.5-1:

**Table 6.4.2.5.5-1: Test requirement for EVM equalizer coefficients for pi/2 BPSK (normal conditions)**

Frequency range	Parameter	Maximum ripple (dB)
$ F_{UL\_Meas} - F_{center}  \leq X$ MHz (Range 1)	X1	6 + TT (p-p)
$ F_{UL\_Meas} - F_{center}  > X$ MHz	X2	14 + TT (p-p)

(Range 2)
<p>NOTE 1: <math>F_{UL\_Meas}</math> refers to the sub-carrier frequency for which the equalizer coefficient is evaluated.</p> <p>NOTE 2: <math>F_{center}</math> refers to the centre frequency of an allocated block of PRBs.</p> <p>NOTE 3: <math>X</math>, in MHz, is equal to 25% of the bandwidth of the PRB allocation.</p> <p>NOTE 4: See Figure 6.4.2.5.5-1 for description of <math>X1</math>, <math>X2</math> and <math>X3</math>.</p>



**Figure 6.4.2.5.5-1: The limits for EVM equalizer spectral flatness with the maximum allowed variation.  $F_{center}$  denotes the centre frequency of the allocated block of PRBs**

The UE passes the test when the derived results for at least one polarization fulfil the test requirements.

## 6.4A Transmit signal quality for CA

### 6.4A.1 Frequency error for CA

#### 6.4A.1.0 Minimum conformance requirements

The requirements in this clause apply to UEs of all power classes.

For intra-band contiguous carrier aggregation, the UE basic measurement interval of modulated carrier frequency is 1 UL slot. The mean value of basic measurements of UE modulated carrier frequencies per band shall be accurate to within  $\pm 0.1$  PPM observed over a period of 1ms of cumulated measurement intervals compared to the carrier frequency of primary component carrier received from the gNB.

The frequency error is defined as a directional requirement. The requirement is verified in beam locked mode on beam peak direction.

#### 6.4A.1.1 Frequency error for CA (2UL CA)

*Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:*

- *Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 400MHz is TBD.*
- *Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.*

##### 6.4A.1.1.1 Test purpose

This test verifies the ability of both, the receiver and the transmitter, to process frequency correctly.

Receiver: to extract the correct frequency from the stimulus signal, offered by the System simulator, under ideal propagation conditions and low level.

Transmitter: to derive the correct modulated carrier frequency from the results, gained by the receiver.

#### 6.4A.1.1.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 2UL CA.

#### 6.4A.1.1.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.4A.1.0.

#### 6.4A.1.1.4 Test description

##### 6.4A.1.1.4.1 Initial condition

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, and channel bandwidths based on NR operating bands specified in clause 5.5A. All of these configurations shall be tested with applicable test parameters for each channel bandwidth and subcarrier spacing, are shown in Table 6.4A.1.1.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.4A.1.1.4.1-1: Test Configuration Table**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1					Normal, TL, TH	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes					Mid range	
Test CC Combination setting (aggregated BW of the CA configuration) as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE					Highest aggregated BW of the CA configuration	
Test SCS as specified in Table 5.3.5-1					Lowest	
Test Parameters						
CA Configuration / Aggregated BW			Downlink Configuration		Uplink Configuration	
Test ID	CC & Mapping (NOTE 4)	CBW (MHz)	Modulation	RB allocation	Modulation	RB allocation (NOTE 1)
1	PCC/CC1	Default	CP-OFDM	Full RB (NOTE 1)	DFT-s-OFDM	REFSENS (NOTE 2)
	SCC/CC2		QPSK		QPSK	
2	PCC/CC1	Default	-	Full RB (NOTE 1)	-	-
	SCC/CC2		CP-OFDM		DFT-s-OFDM	
			QPSK		QPSK	REFSENS (NOTE 2)
NOTE 1: Full RB allocation shall be used per each SCS and channel BW as specified in Table 7.3.2.4.1-2.						
NOTE 2: REFSENS refers to Table 7.3.2.4.1-3 which defines uplink RB configuration and start RB location for each SCS, channel BW and NR band.						
NOTE 3: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".						

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement channels are set according to Table 6.4A.1.1.4.1-1.
5. Propagation conditions are set according to Annex B.0

6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity NR, Connected without release On, Test Mode On and Test Loop Function On according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.4A.1.1.4.3

#### 6.4A.1.1.4.2 Test procedure

1. Retrieve the LO position from the parameter txDirectCurrentLocation in UplinkTxDirectCurrent IE.
2. Configure SCC according to Annex C.0, C.1, C.2 for all downlink physical channels.
3. The SS shall configure SCC as per TS 38.508-1 [10] clause 5.5.1. Message contents are defined in clause 6.4A.1.1.4.3.
4. SS activates SCC by sending the activation MAC CE (Refer TS 38.321 [28], clauses 5.9, 6.1.3.10). Wait for at least 2 seconds (Refer TS 38.133[25], clause 9.3).
5. SS transmits PDSCH via PDCCH DCI format 1\_1 for C\_RNTI to transmit the DL RMC according to Table 6.4A.1.1.4.1-1. The SS sends downlink MAC padding bits on the DL RMC.
6. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.4A.1.1.4.1-1. Since the UL has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC.
7. Set the UE in the Inband Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
8. Send continuously uplink power control "up" commands to the UE in every uplink scheduling information to the UE so that the UE transmits at P<sub>UMAX</sub> level for the duration of the test. Allow at least 200ms starting from the first TPC Command for the UE to reach P<sub>UMAX</sub> level. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
9. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
10. For every UE modulated carrier frequency, measure the Frequency Error using Global In-Channel Tx-Test (Annex E) for the  $\theta$ - and  $\phi$ -polarization. For TDD, only slots consisting of only UL symbols are under test.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

#### 6.4A.1.1.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with TRANSFORM\_PRECODER\_ENABLED condition in Table 4.6.3-118 PUSCH-Config.

#### 6.4A.1.1.5 Test Requirements

The 10 frequency error  $\Delta f$  results for the  $\theta$ -polarization or the 10 frequency error  $\Delta f$  results for the  $\phi$ -polarization must fulfil the test requirement:

$$|\Delta f| \leq (0.1 \text{ PPM} + 0.005 \text{ PPM}), \text{ (for Aggregated BW} \leq 400\text{MHz)}$$

#### 6.4A.1.2 Frequency error for CA (3UL CA)

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 400MHz is TBD.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.

#### 6.4A.1.2.1 Test purpose

This test verifies the ability of both, the receiver and the transmitter, to process frequency correctly.



Receiver: to extract the correct frequency from the stimulus signal, offered by the System simulator, under ideal propagation conditions and low level.

Transmitter: to derive the correct modulated carrier frequency from the results, gained by the receiver.

6.4A.1.2.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 3UL CA.

6.4A.1.2.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.4A.1.0.

6.4A.1.2.4 Test description

Same as in clause 6.4A.1.1.4 with following exceptions:

- Instead of Table 6.4A.1.1.4.1-1 → use Table 6.4A.1.2.4-1.
- Instead of Table 6.4A.1.1.5-1 → use Table 6.4A.1.2.5-1.

**Table 6.4A.1.2.4-1: Test Configuration Table**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal, TL, TH		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes				Mid range		
Test CC Combination setting (aggregated BW of the CA configuration) as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE				Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1				Lowest		
Test Parameters						
CA Configuration / Aggregated BW			Downlink Configuration		Uplink Configuration	
Test ID	CC & Mapping (NOTE 4)	CBW (MHz)	Modulation	RB allocation	Modulation	RB allocation (NOTE 1)
1	PCC/CC1	default	CP-OFDM QPSK	Full RB (NOTE 1)	DFT-s-OFDM QPSK	REFSENS (NOTE 2)
	SCC/CC2		-	-	-	
	SCC/CC3		-	-	-	
2	PCC/CC1		CP-OFDM QPSK	Full RB (NOTE 1)	-	-
	SCC/CC2		-	-	DFT-s-OFDM QPSK	REFSENS (NOTE 2)
	SCC/CC3		-	-	-	-
3	PCC/CC1		CP-OFDM QPSK	Full RB (NOTE 1)	-	-
	SCC/CC2		-	-	-	-
	SCC/CC3		-	-	DFT-s-OFDM QPSK	REFSENS (NOTE 2)
NOTE 1: Full RB allocation shall be used per each SCS and channel BW as specified in Table 7.3.2.4.1-2.						
NOTE 2: REFSENS refers to Table 7.3.2.4.1-3 which defines uplink RB configuration and start RB location for each SCS, channel BW and NR band.						
NOTE 3: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".						

6.4A.1.2.5 Test Requirements

The 10 frequency error Δf results for the θ-polarization or the 10 frequency error Δf results for the φ-polarization must fulfil the test requirement:

$$|\Delta f| \leq (0.1 \text{ PPM} + 0.005 \text{ PPM}), \text{ (for Aggregated BW} \leq 400\text{MHz)}$$

### 6.4A.1.3 Frequency error for CA (4UL CA)

Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:

- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 400MHz is TBD.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.

#### 6.4A.1.3.1 Test purpose

This test verifies the ability of both, the receiver and the transmitter, to process frequency correctly.

Receiver: to extract the correct frequency from the stimulus signal, offered by the System simulator, under ideal propagation conditions and low level.

Transmitter: to derive the correct modulated carrier frequency from the results, gained by the receiver.

#### 6.4A.1.3.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 4UL CA.

#### 6.4A.1.3.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.4A.1.0.

#### 6.4A.1.3.4 Test description

Same as in clause 6.4A.1.1.4 with following exceptions:

- Instead of Table 6.4A.1.1.4.1-1 → use Table 6.4A.1.3.4-1.
- Instead of Table 6.4A.1.1.5-1 → use Table 6.4A.1.3.5-1.

**Table 6.4A.1.3.4-1: Test Configuration Table**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal, TL, TH		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes				Mid range		
Test CC Combination setting (aggregated BW of the CA configuration) as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE				Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1				Lowest		
Test Parameters						
CA Configuration / Aggregated BW			Downlink Configuration		Uplink Configuration	
Test ID	CC & Mapping (NOTE 4)	CBW (MHz)	Modulation	RB allocation	Modulation	RB allocation (NOTE 1)
1	PCC/CC1	Default	CP-OFDM QPSK	Full RB (NOTE 1)	DFT-s-OFDM QPSK	REFSENS (NOTE 2)
	SCC/CC2		-	-	-	
	SCC/CC3		-	-	-	
	SCC/CC4		-	-	-	
2	PCC/CC1	Default	CP-OFDM QPSK	Full RB (NOTE 1)	-	-
	SCC/CC2		-	-	DFT-s-OFDM QPSK	REFSENS (NOTE 2)
	SCC/CC3		-	-	-	-
	SCC/CC4		-	-	-	-
3	PCC/CC1	Default	CP-OFDM QPSK	Full RB (NOTE 1)	-	-

	SCC/CC2	Default	-	-	-	-
	SCC/CC3		-	-	DFT-s-OFDM QPSK	REFSENS (NOTE 2)
	SCC/CC4		-	-	-	-
	PCC/CC1		CP-OFDM QPSK	Full RB (NOTE 1)	-	-
4	SCC/CC2	Default	-	-	-	-
	SCC/CC3		-	-	-	-
	SCC/CC4		-	-	DFT-s-OFDM QPSK	REFSENS (NOTE 2)
NOTE 1: Full RB allocation shall be used per each SCS and channel BW as specified in Table 7.3.2.4.1-2.						
NOTE 2: REFSENS refers to Table 7.3.2.4.1-3 which defines uplink RB configuration and start RB location for each SCS, channel BW and NR band.						
NOTE 3: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: " <i>The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier</i> ".						

#### 6.4A.1.3.5 Test Requirements

The 10 frequency error  $\Delta f$  results for the  $\theta$ -polarization or the 10 frequency error  $\Delta f$  results for the  $\phi$ -polarization must fulfil the test requirement:

$$|\Delta f| \leq (0.1 \text{ PPM} + 0.005 \text{ PPM}), \text{ (for Aggregated BW} \leq 400\text{MHz)}$$

#### 6.4A.1.4 Frequency error for CA (5UL CA)

FFS

#### 6.4A.1.5 Frequency error for CA (6UL CA)

FFS

#### 6.4A.1.6 Frequency error for CA (7UL CA)

FFS

#### 6.4A.1.7 Frequency error for CA (8UL CA)

FFS

### 6.4A.2 Transmit modulation quality for CA

#### 6.4A.2.0 General

For intra-band contiguous carrier aggregation, the requirements in subclauses 6.4A.2.1.0, 6.4A.2.2.0, and 6.4A.2.3.0.

All the parameters defined in subclause 6.4A.2 are defined using the measurement methodology specified in Annex E.

All the requirements in 6.4A.2 are defined as directional requirement. The requirements are verified in beam locked mode on beam peak direction, with both UL polarizations active.

In case the parameter 3300 or 3301 is reported from UE via *txDirectCurrentLocation* IE (as defined in TS 38.331 [19]), carrier leakage measurement requirement in subclause 6.4A.2.2.0 and 6.4A.2.3.0 shall be waived, and the RF correction with regard to the carrier leakage and IQ image shall be omitted during the calculation of transmit modulation quality.

The UE is defined to be configured for CA operation when it has at least one of UL or DL configured for CA.

## 6.4A.2.1 Error vector magnitude for CA

**Editor's note:** This test is incomplete due to lack of RRC framework for LO position retrieval.

### 6.4A.2.1.0 Minimum conformance requirements

The requirements in this subclause apply to UEs of all power classes. For intra-band contiguous carrier aggregation, the Error Vector Magnitude requirement of section 6.4.2.1 is defined for each component carrier. Requirements only apply with PRB allocation in one of the component carriers. Similar transmitter impairment removal procedures are applied for CA waveform before EVM calculation as is specified for non-CA waveform.

### 6.4A.2.1.1 Error vector magnitude for CA (2UL CA)

**Editor's note:** This clause is incomplete. The following aspects are either missing or not yet determined:

- Measurement Uncertainty and Test Tolerance are FFS.

#### 6.4A.2.1.1.1 Test Purpose

For 2UL carrier aggregation, the Error Vector Magnitude requirement should be defined for each component carrier. Requirement applies for the allocated component carrier, when all other component carriers are activated, but not allocated.

Similar transmitter impairment removal procedures are applied for CA waveform before EVM calculation as is specified for non-CA waveform in section 6.4.2.1.

#### 6.4A.2.1.1.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 2UL CA.

#### 6.4A.2.1.1.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.4A.2.1.0

#### 6.4A.2.1.1.4 Test description

##### 6.4A.2.1.1.4.1 Initial conditions

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, test channel bandwidths and sub-carrier spacing based on NR CA configuration specified in clause 5.5A. All of these configurations shall be tested with applicable test parameters for each CA configuration, are shown in Table 6.4A.2.1.1.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annex A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.4A.2.1.1.4.1-1: Test Configuration Table for 2UL CA**

Default Conditions		
Test Environment as specified in TS 38.508-1 [10] subclause 4.1	Normal	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes	Low and High range	
Test CC Combination setting (aggregated BW of the CA configuration) as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE	Lowest aggregated BW of the CA configuration Highest aggregated BW of the CA configuration	
Test SCS as specified in Table 5.3.5-1	Lowest, Highest	
Test Parameters		
CA Configuration / Aggregated BW	Downlink Configuration	Uplink Configuration

Test ID	CC & Mapping (NOTE 3)	CBW (MHz)	RB allocation	Modulation	RB allocation (NOTE 1)
1	PCC/CC1	default	-	DFT-s-OFDM PI/2 BPSK	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	
2	PCC/CC1			DFT-s-OFDM PI/2 BPSK	Outer_Full
	SCC/CC2			-	-
3	PCC/CC1			DFT-s-OFDM QPSK	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
4	PCC/CC1			DFT-s-OFDM QPSK	Outer_Full
	SCC/CC2			-	-
5	PCC/CC1			DFT-s-OFDM 16 QAM	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
6	PCC/CC1			DFT-s-OFDM 16 QAM	Outer_Full
	SCC/CC2			-	-
7	PCC/CC1			DFT-s-OFDM 64 QAM	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
8	PCC/CC1			DFT-s-OFDM 64 QAM	Outer_Full
	SCC/CC2			-	-
9	PCC/CC1			CP-OFDM QPSK	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
10	PCC/CC1			CP-OFDM QPSK	Outer_Full
	SCC/CC2			-	-
11	PCC/CC1			CP-OFDM 16 QAM	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
12	PCC/CC1			CP-OFDM 16 QAM	Outer_Full
	SCC/CC2			-	-
13	PCC/CC1			CP-OFDM 64 QAM	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
14	PCC/CC1			CP-OFDM 64 QAM	Outer_Full
	SCC/CC2			-	-
15 - 28	PCC/CC1				
	SCC/CC2	<b>NOTE 4</b>	<b>NOTE 4</b>		

NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.

NOTE 2: CA Configuration Test cumulative aggregated BW settings are checked separately for each CA Configuration, which applicable aggregated channel bandwidths are specified in Table 5.5A.1-1.

NOTE 3: PCC/CCi and SCC/CCj means PCC is on component carrier CCi and SCC is on component carrier CCj, with CCi or CCj frequencies defined in TS38.508-1 [10].

NOTE 4: Same Modulation and RB allocation of Test ID 1 – 14 are applied to Test ID 15 – 28 in sequence.

NOTE 5: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, in Figure A.3.3.1.1 for TE diagram and section A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals for PCC are initially set up according to Annex C, and uplink signals according to Annex G.

4. The UL Reference Measurement channels are set according to Table 6.4A.2.1.1.4.1-1.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.4A.2.1.1.4.3

#### 6.4A.2.1.1.4.2 Test procedure

1. Retrieve the LO position from the parameter txDirectCurrentLocation in UplinkTxDirectCurrent IE.
2. Configure SCC according to Annex C.0, C.1, C.3 for all downlink physical channels.
3. The SS shall configure SCC as per TS 38.508-1 [10] clause 5.5.1. Message contents are defined in clause 6.4A.2.1.1.4.3.
4. SS activates SCC by sending the activation MAC CE (Refer TS 38.321 [28], clauses 5.9, 6.1.3.10). Wait for at least 2 seconds (Refer TS 38.133[25], clause9.2).
5. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.4A.2.1.1.4.1-1. Since the UE has no payload data to send, the UE transmits uplink MAC padding bits on the UL RMC.
6. Set the UE in the Inband Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 2) for the UE Tx beam selection to complete.
7. Send continuously uplink power control "up" commands in the uplink scheduling information to the UE until the UE transmits at  $P_{UMAX}$  level. Allow at least 200ms starting from the first TPC command in this step for the UE to reach  $P_{UMAX}$  level. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 2) for the UE Tx beam selection to complete.
8. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition TxRx.
9. Measure the  $EVM_{\theta}$ ,  $EVM_{\varphi}$ ,  $\overline{EVM}_{DMRS,\theta}$  and  $\overline{EVM}_{DMRS,\varphi}$  on PCC using Global In-Channel Tx-Test (Annex E) for the  $\theta$ - and  $\varphi$ -polarizations, respectively. For TDD, only slots consisting of only UL symbols are under test. Calculate  $\overline{EVM}_{DMRS} = \min(\overline{EVM}_{DMRS,\theta}, \overline{EVM}_{DMRS,\varphi})$  and  $EVM = \min(EVM_{\theta}, EVM_{\varphi})$ .
10. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

NOTE1: When switching to DFT-s-OFDM waveform, as specified in Table 6.4A.2.1.1.4.1-1, send an NR RRCReconfiguration message according to TS 38.508-1 [10] clause 4.6.3 Table 4.6.3-118 PUSCH-Config with TRANSFORM\_PRECODER\_ENABLED condition.

NOTE 2: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

**Table 6.4A.2.1.1.4.2-1: Void**

**Table 6.4A.2.1.1.4.2-2: Void**

**Table 6.4A.2.1.1.4.2-3: Power Window (dB) for EVM PUSCH**

FFS

#### 6.4A.2.1.1.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6.

## 6.4A.2.1.1.5 Test requirement

The PUSCH EVM, derived in Annex E.4.2, shall not exceed the values in Table 6.4A.2.1.1.5-1.

The PUSCH  $\overline{EVM}_{DMRS}$ , derived in Annex E.4.6.2, shall not exceed the values in Table 6.4A.2.1.1.5-1 when embedded with data symbols of the respective modulation scheme.

**Table 6.4A.2.1.1.5-1: Test requirements for Error Vector Magnitude for CA**

Parameter	Unit	Average EVM Level	Reference Signal EVM Level
Pi/2 BPSK	%	30+TT	30+TT
QPSK	%	17.5+TT	17.5+TT
16 QAM	%	12.5+TT	12.5+TT
64 QAM	%	8+TT	8+TT

**Table 6.4A.2.1.1.5-2: Test Tolerance for Error Vector Magnitude for CA**

Test Metric	FR2a	FR2b
Max device size $\leq$ 30 cm	FFS	FFS

## 6.4A.2.1.2 Error vector magnitude for CA (3UL CA)

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- Measurement Uncertainty and Test Tolerance are FFS.

## 6.4A.2.1.2.1 Test Purpose

For 3UL carrier aggregation, the Error Vector Magnitude requirement should be defined for each component carrier. Requirement applies for the allocated component carrier, when all other component carriers are activated, but not allocated.

Similar transmitter impairment removal procedures are applied for CA waveform before EVM calculation as is specified for non-CA waveform in clause 6.4.2.1.

## 6.4A.2.1.2.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 3UL CA.

## 6.4A.2.1.2.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.4A.2.1.0

## 6.4A.2.1.2.4 Test description

Same as in clause 6.4A.2.1.1.4 with following exceptions:

- Instead of Table 6.4A.2.1.1.4.1-1  $\rightarrow$  use Table 6.4A.2.1.2.4-1.
- Instead of Table 6.4A.2.1.1.5-1  $\rightarrow$  use Table 6.4A.2.1.2.5-1.

**Table 6.4A.2.1.2.4-1: Test Configuration Table for 3UL CA**

Default Conditions	
Test Environment as specified in TS 38.508-1 [10] subclause 4.1	Normal
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes	Low and High range
Test CC Combination setting (aggregated BW of the CA configuration) as specified in TS 38.508-1 [10] subclause	Lowest aggregated BW of the CA configuration Highest aggregated BW of the CA configuration

4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE					
Test SCS as specified in Table 5.3.5-1				Lowest, Highest	
Test Parameters					
CA Configuration / Aggregated BW			Downlink Configuration	Uplink Configuration	
Test ID	CC & Mapping (NOTE 3)	CBW (MHz)	RB allocation	Modulation	RB allocation (NOTE 1)
1	PCC/CC1	default	-	DFT-s-OFDM PI/2 BPSK	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
	SCC/CC3			-	-
2	PCC/CC1			DFT-s-OFDM PI/2 BPSK	Outer_Full
	SCC/CC2			-	-
	SCC/CC3			-	-
3	PCC/CC1			DFT-s-OFDM QPSK	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
	SCC/CC3			-	-
4	PCC/CC1			DFT-s-OFDM QPSK	Outer_Full
	SCC/CC2			-	-
	SCC/CC3			-	-
5	PCC/CC1			DFT-s-OFDM 16 QAM	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
	SCC/CC3			-	-
6	PCC/CC1	DFT-s-OFDM 16 QAM	Outer_Full		
	SCC/CC2	-	-		
	SCC/CC3	-	-		
7	PCC/CC1	DFT-s-OFDM 64 QAM	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1		
	SCC/CC2	-	-		
	SCC/CC3	-	-		
8	PCC/CC1	DFT-s-OFDM 64 QAM	Outer_Full		
	SCC/CC2	-	-		
	SCC/CC3	-	-		
9	PCC/CC1	CP-OFDM QPSK	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1		
	SCC/CC2	-	-		
	SCC/CC3	-	-		
10	PCC/CC1	CP-OFDM QPSK	Outer_Full		
	SCC/CC2	-	-		
	SCC/CC3	-	-		
11	PCC/CC1	CP-OFDM 16 QAM	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1		
	SCC/CC2	-	-		
	SCC/CC3	-	-		
12	PCC/CC1	CP-OFDM 16 QAM	Outer_Full		
	SCC/CC2	-	-		
	SCC/CC3	-	-		
13	PCC/CC1	CP-OFDM 64 QAM	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1		
	SCC/CC2	-	-		
	SCC/CC3	-	-		
14	PCC/CC1	CP-OFDM 64 QAM	Outer_Full		
	SCC/CC2	-	-		
	SCC/CC3	-	-		
15 - 28	PCC/CC1	-	-		
	SCC/CC2	-	-		



SCC/CC3	NOTE 4	NOTE 4
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.		
NOTE 2: CA Configuration Test cumulative aggregated BW settings are checked separately for each CA Configuration, which applicable aggregated channel bandwidths are specified in Table 5.5A.1-1.		
NOTE 3: PCC/CCi and SCC/CCj means PCC is on component carrier CCi and SCC is on component carrier CCj, with CCi or CCj frequencies defined in TS38.508-1 [10].		
NOTE 4: Same Modulation and RB allocation of Test ID 1 – 14 are applied to Test ID 15 – 28 in sequence.		
NOTE 5: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".		

#### 6.4A.2.1.2.5 Test requirement

The PUSCH EVM, derived in Annex E.4.2, shall not exceed the values in Table 6.4A.2.1.2.5-1.

The PUSCH  $\overline{EVM}_{DMRS}$ , derived in Annex E.4.6.2, shall not exceed the values in Table 6.4A.2.1.2.5-1 when embedded with data symbols of the respective modulation scheme.

**Table 6.4A.2.1.2.5-1: Test requirements for Error Vector Magnitude**

Parameter	Unit	Average EVM Level	Reference Signal EVM Level
Pi/2 BPSK	%	30+TT	30+TT
QPSK	%	17.5+TT	17.5+TT
16 QAM	%	12.5+TT	12.5+TT
64 QAM	%	8+TT	8+TT

**Table 6.4A.2.1.2.5-2: Test Tolerance for Error Vector Magnitude for CA**

Test Metric	FR2a	FR2b
Max device size $\leq$ 30 cm	FFS	FFS

#### 6.4A.2.1.3 Error vector magnitude for CA (4UL CA)

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- **Measurement Uncertainty and Test Tolerance are FFS.**

##### 6.4A.2.1.3.1 Test Purpose

For 4UL carrier aggregation, the Error Vector Magnitude requirement should be defined for each component carrier. Requirement applies for the allocated component carrier, when all other component carriers are activated, but not allocated.

Similar transmitter impairment removal procedures are applied for CA waveform before EVM calculation as is specified for non-CA waveform in clause 6.4.2.1.

##### 6.4A.2.1.3.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 4UL CA.

##### 6.4A.2.1.3.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.4A.2.1.0

6.4A.2.1.3.4 Test description

Same as in clause 6.4A.2.1.1.4 with following exceptions:

- Instead of Table 6.4A.2.1.1.4.1-1 → use Table 6.4A.2.1.3.4-1.
- Instead of Table 6.4A.2.1.1.5-1 → use Table 6.4A.2.1.3.5-1.

**Table 6.4A.2.1.3.4-1: Test Configuration Table for 4UL CA**

Default Conditions					
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes			Low and High range		
Test CC Combination setting (aggregated BW of the CA configuration) as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE			Lowest aggregated BW of the CA configuration Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1			Lowest, Highest		
Test Parameters					
CA Configuration / Aggregated BW			Downlink Configuration	Uplink Configuration	
Test ID	CC & Mapping (NOTE 3)	CBW (MHz)	RB allocation	Modulation	RB allocation (NOTE 1)
1	PCC/CC1	default	-	DFT-s-OFDM PI/2 BPSK	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
2	PCC/CC1			DFT-s-OFDM PI/2 BPSK	Outer_Full
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
3	PCC/CC1			DFT-s-OFDM QPSK	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
4	PCC/CC1			DFT-s-OFDM QPSK	Outer_Full
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
5	PCC/CC1			DFT-s-OFDM 16 QAM	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
6	PCC/CC1	DFT-s-OFDM 16 QAM	Outer_Full		
	SCC/CC2	-	-		
	SCC/CC3	-	-		
	SCC/CC4	-	-		
7	PCC/CC1	DFT-s-OFDM 64 QAM	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1		
	SCC/CC2	-	-		
	SCC/CC3	-	-		
	SCC/CC4	-	-		
8	PCC/CC1	DFT-s-OFDM 64 QAM	Outer_Full		
	SCC/CC2	-	-		
	SCC/CC3	-	-		
	SCC/CC4	-	-		
9	PCC/CC1	CP-OFDM QPSK	Inner_Full for PC2, PC3, PC4		

					Inner_Full_Region1 for PC1
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
10	PCC/CC1			CP-OFDM QPSK	Outer_Full
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
11	PCC/CC1			CP-OFDM 16 QAM	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
12	PCC/CC1			CP-OFDM 16 QAM	Outer_Full
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
13	PCC/CC1			CP-OFDM 64 QAM	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
14	PCC/CC1			CP-OFDM 64 QAM	Outer_Full
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
15 - 28	PCC/CC1			-	-
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
			<b>NOTE 4</b>	<b>NOTE 4</b>	

NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.  
 NOTE 2: CA Configuration Test cumulative aggregated BW settings are checked separately for each CA Configuration, which applicable aggregated channel bandwidths are specified in Table 5.5A.1-1.  
 NOTE 3: PCC/CCi and SCC/CCj means PCC is on component carrier CCi and SCC is on component carrier CCj, with CCi or CCj frequencies defined in TS38.508-1 [10].  
 NOTE 4: Same Modulation and RB allocation of Test ID 1 – 14 are applied to Test ID 15 – 28 in sequence.  
 NOTE 5: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".

6.4A.2.1.3.5 Test requirement

The PUSCH EVM, derived in Annex E.4.2, shall not exceed the values in Table 6.4A.2.1.3.5-1.

The PUSCH  $\overline{EVM}_{DMRS}$ , derived in Annex E.4.6.2, shall not exceed the values in Table 6.4A.2.1.3.5-1 when embedded with data symbols of the respective modulation scheme.

**Table 6.4A.2.1.3.5-1: Test requirements for Error Vector Magnitude**

Parameter	Unit	Average EVM Level	Reference Signal EVM Level
Pi/2 BPSK	%	30+TT	30+TT
QPSK	%	17.5+TT	17.5+TT
16 QAM	%	12.5+TT	12.5+TT
64 QAM	%	8+TT	8+TT

**Table 6.4A.2.1.3.5-2: Test Tolerance for Error Vector Magnitude for CA**

Test Metric	FR2a	FR2b
Max device size ≤ 30 cm	FFS	FFS

6.4A.2.1.4 Error Vector magnitude for CA (5UL CA)

Editor’s note: This clause is incomplete. The following aspects are either missing or not yet determined:

- Measurement Uncertainty and Test Tolerance are FFS.

6.4A.2.1.4.1 Test Purpose

For 5UL carrier aggregation, the Error Vector Magnitude requirement should be defined for each component carrier. Requirement applies for the allocated component carrier, when all other component carriers are activated, but not allocated.

Similar transmitter impairment removal procedures are applied for CA waveform before EVM calculation as is specified for non-CA waveform in clause 6.4.2.1.

6.4A.2.1.4.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 5UL CA.

6.4A.2.1.4.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.4A.2.1.0

6.4A.2.1.4.4 Test description

Same as in clause 6.4A.2.1.1.4 with following exceptions:

- Instead of Table 6.4A.2.1.1.4.1-1 → use Table 6.4A.2.1.4.4-1.
- Instead of Table 6.4A.2.1.1.5-1 → use Table 6.4A.2.1.4.5-1.

**Table 6.4A.2.1.4.4-1: Test Configuration Table for 5UL CA**

Default Conditions					
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes			Low and High range		
Test CC Combination setting (aggregated BW of the CA configuration) as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE			Lowest aggregated BW of the CA configuration Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1			Lowest, Highest		
Test Parameters					
CA Configuration / Aggregated BW			Downlink Configuration	Uplink Configuration	
Test ID	CC & Mapping (NOTE 3)	CBW (MHz)	RB allocation	Modulation	RB allocation (NOTE 1)
1	PCC/CC1	default	-	DFT-s-OFDM PI/2 BPSK	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
2	PCC/CC1	default	-	DFT-s-OFDM PI/2 BPSK	Outer_Full
	SCC/CC2			-	-

	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
3	PCC/CC1			DFT-s-OFDM QPSK	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
4	PCC/CC1			DFT-s-OFDM QPSK	Outer_Full
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
5	PCC/CC1			DFT-s-OFDM 16 QAM	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
6	PCC/CC1			DFT-s-OFDM 16 QAM	Outer_Full
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
7	PCC/CC1			DFT-s-OFDM 64 QAM	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
8	PCC/CC1			DFT-s-OFDM 64 QAM	Outer_Full
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
9	PCC/CC1			CP-OFDM QPSK	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
10	PCC/CC1			CP-OFDM QPSK	Outer_Full
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
11	PCC/CC1			CP-OFDM 16 QAM	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
12	PCC/CC1			CP-OFDM 16 QAM	Outer_Full
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
13	PCC/CC1			CP-OFDM 64 QAM	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-

	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
14	PCC/CC1			CP-OFDM 64 QAM	Outer_Full
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
15 - 28	PCC/CC1			-	-
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			<b>NOTE 4</b>	<b>NOTE 4</b>

NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.  
 NOTE 2: CA Configuration Test cumulative aggregated BW settings are checked separately for each CA Configuration, which applicable aggregated channel bandwidths are specified in Table 5.5A.1-1.  
 NOTE 3: PCC/CCi and SCC/CCj means PCC is on component carrier CCi and SCC is on component carrier CCj, with CCi or CCj frequencies defined in TS38.508-1 [10].  
 NOTE 4: Same Modulation and RB allocation of Test ID 1 – 14 are applied to Test ID 15 – 28 in sequence.  
 NOTE 5: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".

6.4A.2.1.4.5 Test requirement

The PUSCH EVM, derived in Annex E.4.2, shall not exceed the values in Table 6.4A.2.1.4.5-1.

The PUSCH  $\overline{EVM}_{DMRS}$ , derived in Annex E.4.6.2, shall not exceed the values in Table 6.4A.2.1.4.5-1 when embedded with data symbols of the respective modulation scheme.

**Table 6.4A.2.1.4.5-1: Test requirements for Error Vector Magnitude for CA**

Parameter	Unit	Average EVM Level	Reference Signal EVM Level
Pi/2 BPSK	%	30+TT	30+TT
QPSK	%	17.5+TT	17.5+TT
16 QAM	%	12.5+TT	12.5+TT
64 QAM	%	8+TT	8+TT

**Table 6.4A.2.1.4.5-2: Test Tolerance for Error Vector Magnitude for CA**

Test Metric	FR2a	FR2b
Max device size ≤ 30 cm	FFS	FFS

6.4A.2.1.5 Error Vector magnitude for CA (6UL CA)

**Editor’s note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- Measurement Uncertainty and Test Tolerance are FFS.

6.4A.2.1.5.1 Test Purpose

For 6UL carrier aggregation, the Error Vector Magnitude requirement should be defined for each component carrier. Requirement applies for the allocated component carrier, when all other component carriers are activated, but not allocated.

Similar transmitter impairment removal procedures are applied for CA waveform before EVM calculation as is specified for non-CA waveform in clause 6.4.2.1.

6.4A.2.1.5.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 6UL CA.

6.4A.2.1.5.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.4A.2.1.0

6.4A.2.1.5.4 Test description

Same as in clause 6.4A.2.1.1.4 with following exceptions:

- Instead of Table 6.4A.2.1.1.4.1-1 → use Table 6.4A.2.1.5.4-1.
- Instead of Table 6.4A.2.1.1.5-1 → use Table 6.4A.2.1.5.5-1.

**Table 6.4A.2.1.5.4-1: Test Configuration Table for 6UL CA**

Default Conditions					
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes			Low and High range		
Test CC Combination setting (aggregated BW of the CA configuration) as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE			Lowest aggregated BW of the CA configuration Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1			Lowest, Highest		
Test Parameters					
CA Configuration / Aggregated BW			Downlink Configuration	Uplink Configuration	
Test ID	CC & Mapping (NOTE 3)	CBW (MHz)	RB allocation	Modulation	RB allocation (NOTE 1)
1	PCC/CC1	default	-	DFT-s-OFDM PI/2 BPSK	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
2	PCC/CC1			DFT-s-OFDM PI/2 BPSK	Outer_Full
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
3	PCC/CC1			DFT-s-OFDM QPSK	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
4	PCC/CC1			DFT-s-OFDM QPSK	Outer_Full
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
5	PCC/CC1	DFT-s-OFDM 16 QAM	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1		
	SCC/CC2	-	-		

	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
6	PCC/CC1			DFT-s-OFDM 16 QAM	Outer_Full
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
7	PCC/CC1			DFT-s-OFDM 64 QAM	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
8	PCC/CC1			DFT-s-OFDM 64 QAM	Outer_Full
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
9	PCC/CC1			CP-OFDM QPSK	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
10	PCC/CC1			CP-OFDM QPSK	Outer_Full
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
11	PCC/CC1			CP-OFDM 16 QAM	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
12	PCC/CC1			CP-OFDM 16 QAM	Outer_Full
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
13	PCC/CC1			CP-OFDM 64 QAM	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
14	PCC/CC1			CP-OFDM 64 QAM	Outer_Full
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-



15 -28	PCC/CC1			-	-
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			<b>NOTE 4</b>	<b>NOTE 4</b>

NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.

NOTE 2: CA Configuration Test cumulative aggregated BW settings are checked separately for each CA Configuration, which applicable aggregated channel bandwidths are specified in Table 5.5A.1-1.

NOTE 3: PCC/CCi and SCC/CCj means PCC is on component carrier CCi and SCC is on component carrier CCj, with CCi or CCj frequencies defined in TS38.508-1 [10].

NOTE 4: Same Modulation and RB allocation of Test ID 1 – 14 are applied to Test ID 15 – 28 in sequence.

NOTE 5: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".

#### 6.4A.2.1.5.5 Test requirement

The PUSCH EVM, derived in Annex E.4.2, shall not exceed the values in Table 6.4A.2.1.5.5-1.

The PUSCH  $\overline{EVM}_{DMRS}$ , derived in Annex E.4.6.2, shall not exceed the values in Table 6.4A.2.1.5.5-1 when embedded with data symbols of the respective modulation scheme.

**Table 6.4A.2.1.5.5-1: Test requirements for Error Vector Magnitude for CA**

Parameter	Unit	Average EVM Level	Reference Signal EVM Level
Pi/2 BPSK	%	30+TT	30+TT
QPSK	%	17.5+TT	17.5+TT
16 QAM	%	12.5+TT	12.5+TT
64 QAM	%	8+TT	8+TT

**Table 6.4A.2.1.5.5-2: Test Tolerance for Error Vector Magnitude for CA**

Test Metric	FR2a	FR2b
Max device size ≤ 30 cm	FFS	FFS

#### 6.4A.2.1.6 Error vector magnitude for CA (7UL CA)

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- **Measurement Uncertainty and Test Tolerance are FFS.**

##### 6.4A.2.1.6.1 Test Purpose

For 7UL carrier aggregation, the Error Vector Magnitude requirement should be defined for each component carrier. Requirement applies for the allocated component carrier, when all other component carriers are activated, but not allocated.

Similar transmitter impairment removal procedures are applied for CA waveform before EVM calculation as is specified for non-CA waveform in sub-section 6.4.2.1.

##### 6.4A.2.1.6.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 7UL CA.

6.4A.2.1.6.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.4A.2.1.0

6.4A.2.1.6.4 Test description

Same as in clause 6.4A.2.1.1.4 with following exceptions:

- Instead of Table 6.4A.2.1.1.4.1-1 → use Table 6.4A.2.1.6.4-1.
- Instead of Table 6.4A.2.1.1.5-1 → use Table 6.4A.2.1.6.5-1.

**Table 6.4A.2.1.6.4-1: Test Configuration Table for 7UL CA**

Default Conditions					
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes			Low and High range		
Test CC Combination setting (aggregated BW of the CA configuration) as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE			Lowest aggregated BW of the CA configuration Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1			Lowest, Highest		
Test Parameters					
CA Configuration / Aggregated BW			Downlink Configuration	Uplink Configuration	
Test ID	CC & Mapping (NOTE 3)	CBW (MHz)	RB allocation	Modulation	RB allocation (NOTE 1)
1	PCC/CC1	default	-	DFT-s-OFDM PI/2 BPSK	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
	SCC/CC7			-	-
2	PCC/CC1			DFT-s-OFDM PI/2 BPSK	Outer_Full
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
	SCC/CC7			-	-
3	PCC/CC1			DFT-s-OFDM QPSK	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
	SCC/CC7			-	-
4	PCC/CC1			DFT-s-OFDM QPSK	Outer_Full
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
	SCC/CC7			-	-
5	PCC/CC1	DFT-s-OFDM 16 QAM	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1		
	SCC/CC2	-	-		
	SCC/CC3	-	-		

	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
	SCC/CC7			-	-
6	PCC/CC1			DFT-s-OFDM 16 QAM	Outer_Full
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
7	PCC/CC1			DFT-s-OFDM 64 QAM	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
	SCC/CC7			-	-
8	PCC/CC1			DFT-s-OFDM 64 QAM	Outer_Full
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
	SCC/CC7			-	-
9	PCC/CC1			CP-OFDM QPSK	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
	SCC/CC7			-	-
10	PCC/CC1			CP-OFDM QPSK	Outer_Full
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
	SCC/CC7			-	-
11	PCC/CC1			CP-OFDM 16 QAM	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
	SCC/CC7			-	-
12	PCC/CC1			CP-OFDM 16 QAM	Outer_Full
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
	SCC/CC7			-	-
13	PCC/CC1			CP-OFDM 64 QAM	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-

14	SCC/CC6			-	-
	SCC/CC7			-	-
	PCC/CC1			CP-OFDM 64 QAM	Outer_Full
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
15 - 28	SCC/CC7			-	-
	PCC/CC1			-	-
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
	SCC/CC7			-	-
				<b>NOTE 4</b>	<b>NOTE 4</b>

NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.  
 NOTE 2: CA Configuration Test cumulative aggregated BW settings are checked separately for each CA Configuration, which applicable aggregated channel bandwidths are specified in Table 5.5A.1-1.  
 NOTE 3: PCC/CCi and SCC/CCj means PCC is on component carrier CCi and SCC is on component carrier CCj, with CCi or CCj frequencies defined in TS38.508-1 [10].  
 NOTE 4: Same Modulation and RB allocation of Test ID 1 – 14 are applied to Test ID 15 – 28 in sequence.  
 NOTE 5: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".

6.4A.2.1.6.5 Test requirement

The PUSCH EVM, derived in Annex E.4.2, shall not exceed the values in Table 6.4A.2.1.6.5-1.

The PUSCH  $\overline{EVM}_{DMRS}$ , derived in Annex E.4.6.2, shall not exceed the values in Table 6.4A.2.1.6.5-1 when embedded with data symbols of the respective modulation scheme.

**Table 6.4A.2.1.6.5-1: Test requirements for Error Vector Magnitude for CA**

Parameter	Unit	Average EVM Level	Reference Signal EVM Level
Pi/2 BPSK	%	30+TT	30+TT
QPSK	%	17.5+TT	17.5+TT
16 QAM	%	12.5+TT	12.5+TT
64 QAM	%	8+TT	8+TT

**Table 6.4A.2.1.6.5-2: Test Tolerance for Error Vector Magnitude for CA**

Test Metric	FR2a	FR2b
Max device size ≤ 30 cm	FFS	FFS

6.4A.2.1.7 Error vector magnitude for CA (8UL CA)

Editor’s note: This clause is incomplete. The following aspects are either missing or not yet determined:

- Measurement Uncertainty and Test Tolerance are FFS.

6.4A.2.1.7.1 Test Purpose

For 8UL carrier aggregation, the Error Vector Magnitude requirement should be defined for each component carrier. Requirement applies for the allocated component carrier, when all other component carriers are activated, but not allocated.

Similar transmitter impairment removal procedures are applied for CA waveform before EVM calculation as is specified for non-CA waveform in sub-section 6.4.2.1.

6.4A.2.1.7.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 8UL CA.

6.4A.2.1.7.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.4A.2.1.0

6.4A.2.1.7.4 Test description

Same as in clause 6.4A.2.1.1.4 with following exceptions:

- Instead of Table 6.4A.2.1.1.4.1-1 → use Table 6.4A.2.1.7.4-1.
- Instead of Table 6.4A.2.1.1.5-1 → use Table 6.4A.2.1.7.5-1.

**Table 6.4A.2.1.7.4-1: Test Configuration Table for 8UL CA**

Default Conditions					
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes			Low and High range		
Test CC Combination setting (aggregated BW of the CA configuration) as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE			Lowest aggregated BW of the CA configuration Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1			Lowest, Highest		
Test Parameters					
CA Configuration / Aggregated BW			Downlink Configuration	Uplink Configuration	
Test ID	CC & Mapping (NOTE 3)	CBW (MHz)	RB allocation	Modulation	RB allocation (NOTE 1)
1	PCC/CC1	default	-	DFT-s-OFDM PI/2 BPSK	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
	SCC/CC7			-	-
	SCC/CC8			-	-
2	PCC/CC1			DFT-s-OFDM PI/2 BPSK	Outer_Full
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
	SCC/CC7			-	-
	SCC/CC8			-	-
3	PCC/CC1			DFT-s-OFDM QPSK	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
	SCC/CC7			-	-
	SCC/CC8			-	-
4	PCC/CC1	DFT-s-OFDM QPSK	Outer_Full		

	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
	SCC/CC7			-	-
	SCC/CC8			-	-
	5	PCC/CC1			DFT-s-OFDM 16 QAM
SCC/CC2				-	-
SCC/CC3				-	-
SCC/CC4				-	-
SCC/CC5				-	-
SCC/CC6				-	-
SCC/CC7				-	-
SCC/CC8				-	-
6	PCC/CC1			DFT-s-OFDM 16 QAM	Outer_Full
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
	SCC/CC7			-	-
	SCC/CC8			-	-
7	PCC/CC1			DFT-s-OFDM 64 QAM	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
	SCC/CC7			-	-
	SCC/CC8			-	-
8	PCC/CC1			DFT-s-OFDM 64 QAM	Outer_Full
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
	SCC/CC7			-	-
	SCC/CC8			-	-
9	PCC/CC1			CP-OFDM QPSK	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
	SCC/CC7			-	-
	SCC/CC8			-	-
10	PCC/CC1			CP-OFDM QPSK	Outer_Full
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
	SCC/CC7			-	-
	SCC/CC8			-	-
11	PCC/CC1			CP-OFDM 16 QAM	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
	SCC/CC3			-	-

	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
	SCC/CC7			-	-
	SCC/CC8			-	-
12	PCC/CC1			CP-OFDM 16 QAM	Outer_Full
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
	SCC/CC7			-	-
13	SCC/CC8			-	-
	PCC/CC1			CP-OFDM 64 QAM	Inner_Full for PC2, PC3, PC4 Inner_Full_Region1 for PC1
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
	SCC/CC7			-	-
14	SCC/CC8			-	-
	PCC/CC1			CP-OFDM 64 QAM	Outer_Full
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
	SCC/CC7			-	-
15 -28	SCC/CC8			-	-
	PCC/CC1			-	-
	SCC/CC2			-	-
	SCC/CC3			-	-
	SCC/CC4			-	-
	SCC/CC5			-	-
	SCC/CC6			-	-
	SCC/CC7			-	-
	SCC/CC8			<b>NOTE 4</b>	<b>NOTE 4</b>

NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.  
 NOTE 2: CA Configuration Test cumulative aggregated BW settings are checked separately for each CA Configuration, which applicable aggregated channel bandwidths are specified in Table 5.5A.1-1.  
 NOTE 3: PCC/CCi and SCC/CCj means PCC is on component carrier CCi and SCC is on component carrier CCj, with CCi or CCj frequencies defined in TS38.508-1 [10].  
 NOTE 4: Same Modulation and RB allocation of Test ID 1 – 14 are applied to Test ID 15 – 28 in sequence.  
 NOTE 5: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".

6.4A.2.1.7.5 Test requirement

The PUSCH EVM, derived in Annex E.4.2, shall not exceed the values in Table 6.4A.2.1.7.5-1.

The PUSCH  $\overline{EVM}_{DMRS}$ , derived in Annex E.4.6.2, shall not exceed the values in Table 6.4A.2.1.7.5-1 when embedded with data symbols of the respective modulation scheme.

**Table 6.4A.2.1.7.5-1: Test requirements for Error Vector Magnitude for CA**

Parameter	Unit	Average EVM Level	Reference Signal EVM Level
Pi/2 BPSK	%	30+TT	30+TT

QPSK	%	17.5+TT	17.5+TT
16 QAM	%	12.5+TT	12.5+TT
64 QAM	%	8+TT	8+TT

**Table 6.4A.2.1.7.5-2: Test Tolerance for Error Vector Magnitude for CA**

Test Metric	FR2a	FR2b
Max device size $\leq$ 30 cm	FFS	FFS

## 6.4A.2.2 Carrier leakage for CA

*Editor's note: This test is incomplete due to lack of RRC framework for LO position retrieval.*

### 6.4A.2.2.0 Minimum conformance requirements

#### 6.4A.2.2.0.1 General

Carrier leakage is an additive sinusoid waveform. The carrier leakage requirement is defined for each component carrier and is measured on the component carrier with PRBs allocated. The measurement interval is one slot in the time domain.

Note: When UE has DL configured for non-contiguous CA, carrier leakage may land outside the spectrum occupied by all configured UL and DL CC.

The relative carrier leakage power is a power ratio of the additive sinusoid waveform and the modulated waveform. The requirement is verified with the test metric of Carrier Leakage (Link=TX beam peak direction, Meas=Link angle).

#### 6.4A.2.2.0.2 Carrier leakage for power class 1

When carrier leakage is contained inside the spectrum occupied by all configured UL and DL CCs, the relative carrier leakage power shall not exceed the values specified in Table 6.4A.2.2.0.2-1 for power class 1 UEs.

**Table 6.4A.2.2.0.2-1: Minimum requirements for relative carrier leakage for power class 1**

Parameters	Relative Limit (dBc)
EIRP > 17 dBm	-25
4 dBm $\leq$ EIRP $\leq$ 17 dBm	-20

#### 6.4A.2.2.0.3 Carrier leakage for power class 2

When carrier leakage is contained inside the spectrum occupied by all configured UL and DL CCs, the relative carrier leakage power shall not exceed the values specified in Table 6.4A.2.2.0.3-1 for power class 2.

**Table 6.4A.2.2.0.3-1: Minimum requirements for relative carrier leakage power class 2**

Parameters	Relative limit (dBc)
EIRP > 6 dBm	-25
-13 dBm $\leq$ EIRP $\leq$ 6 dBm	-20

#### 6.4A.2.2.0.4 Carrier leakage for power class 3

When carrier leakage is contained inside the spectrum occupied by all configured UL and DL CCs, the relative carrier leakage power shall not exceed the values specified in Table 6.4A.2.2.0.4-1 for power class 3 UEs.

**Table 6.4A.2.2.0.4-1: Minimum requirements for relative carrier leakage power class 3**

Parameters	Relative limit (dBc)
Output power > 0 dBm	-25



-13 dBm ≤ Output power EIRP ≤ 0 dBm	-20
-------------------------------------	-----

#### 6.4A.2.2.0.5 Carrier leakage for power class 4

When carrier leakage is contained inside the spectrum occupied by all configured UL and DL CCs, the relative carrier leakage power shall not exceed the values specified in Table 6.4A.2.2.0.5-1 for power class 4 UEs.

**Table 6.4A.2.2.0.5-1: Minimum requirements for relative carrier leakage power class 4**

Parameters	Relative limit (dBc)
Output power > 11 dBm	-25
-13 dBm ≤ Output power EIRP ≤ 11 dBm	-20

#### 6.4A.2.2.1 Carrier leakage for CA (2UL CA)

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- This test is incomplete due to lack of RRC framework for LO position retrieval.
- Power window is TBD for power class 1, 2 and 4.
- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA is TBD.

##### 6.4A.2.2.1.1 Test purpose

Carrier leakage expresses itself as unmodulated sine wave with the carrier frequency. It is an interference of approximately constant amplitude and independent of the amplitude of the wanted signal. Carrier leakage interferes with the sub carriers at its position (if allocated), especially, when their amplitude is small.

The purpose of this test is to exercise the UE transmitter to verify its modulation quality in terms of carrier leakage.

##### 6.4A.2.2.1.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 2UL CA.

##### 6.4A.2.2.1.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.4A.2.2.0.

##### 6.4A.2.2.1.4 Test description

##### 6.4A.2.2.1.4.1 Initial condition

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, and CC combinations based on NR operating bands specified in clause 5.5A. All of these configurations shall be tested with applicable test parameters for each CA configuration and subcarrier spacing, are shown in Table 6.4A.2.2.1.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.4A.2.2.1.4.1-1: Intra-band Contiguous CA Test Configuration Table**

Default Conditions	
Test Environment as specified in TS 38.508-1 [10] subclause 4.1	Normal
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth	Low and High range

classes						
Test CC Combination setting (aggregated BW of the CA configuration) as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE			Lowest aggregated BW of the CA configuration			
Test SCS as specified in Table 5.3.5-1			Highest			
Test Parameters						
CA Configuration / Aggregated BW			Downlink Configuration	Uplink Configuration		
Test ID	CC & Mapping (NOTE 5)	CBW (MHz)	RB allocation	Modulation	RB allocation (NOTE 1)	
1	PCC/CC1	Default	-	DFT-s-OFDM QPSK	Inner_Partial_Left for PC2, PC3, PC4	
	SCC/CC2				Inner_Partial_Left_Region2 for PC1	
NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.						
NOTE 2: CA Configuration Test cumulative aggregated BW settings are checked separately for each CA Configuration, which applicable aggregated channel bandwidths are specified in Table 5.5A.1-1.						
NOTE 3: If the UE supports multiple CC Combinations in the CA Configuration with the same cumulative aggregated BW, only the combination with the lowest PCC ChBW is tested.						
NOTE 4: When the signalled DC carrier position is at Inner_Partial_Left for PC2, PC3, PC4, use Inner_Partial_Right for UL RB allocation. When the signalled DC carrier position is in Inner_Partial_Left_Region2 for PC1, use Inner_Partial_Right_Region2 for UL RB allocation.						
NOTE 5: PCC/CC <sub>i</sub> and SCC/CC <sub>j</sub> means PCC is on component carrier CC <sub>i</sub> and SCC is on component carrier CC <sub>j</sub> , with CC <sub>i</sub> or CC <sub>j</sub> frequencies defined in TS38.508-1 [10].						
NOTE 6: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".						

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement channels are set according to Table 6.4A.2.2.1.4.1-1.
5. Propagation conditions are set according to Annex B.0
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.4A.2.2.1.4.3

#### 6.4A.2.2.1.4.2 Test procedure

1. Retrieve the LO position from the parameter txDirectCurrentLocation in UplinkTxDirectCurrent IE.
2. Configure PCC and SCC according to Annex C.0, C.1, C.2 and Annex C.3.0 for all downlink physical channels.
3. The SS shall configure SCC as per TS 38.508-1 [10] clause 5.5.1 Procedure to configure SCC(s) for NR RF CA testing. Message contents are defined in clause 6.4A.2.2.1.4.3.
4. SS activates SCC by sending the activation MAC CE (Refer TS 38.321 [28], clauses 5.9, 6.1.3.10). Wait for at least 2 seconds (Refer TS 38.133[25], clause 9.3).
5. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.4A.2.2.1.4.1-1. Since the UE has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC.

6. Set the UE in the Inband Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
7. Send uplink power control commands to the UE using 1dB power step size to ensure that the UE  $EIRP_{Total} = EIRP_{\theta} + EIRP_{\phi}$  measured by the test system is within the Uplink power control window, defined as +MU to +(MU + Uplink power control window size) dB of the target power level  $P_{req}$ , where:
  - $P_{req}$  is the power level specified in Table 6.4.2.2.4.2-1 according to the power class.
  - MU is the test system uplink absolute power measurement uncertainty and is specified in Table F.1.2-1 under carrier leakage sub-clause for the carrier frequency  $f$  and the channel bandwidth BW.
  - Uplink power control window size = 1dB (UE power step size) + 5 dB (UE power step tolerance) + (Test system uplink relative power measurement uncertainty), where, the UE power step tolerance is specified in TS 38.101-1 [2], Table 6.3.4.3-1 and is 5dB for 1dB power step size, and the Test system uplink relative power measurement uncertainty is specified in Table F.1.2-1.

Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.

8. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition TxRx.
9. Measure carrier leakage on PCC using Global In-Channel Tx-Test (Annex E) for the  $\theta$ - and  $\phi$ -polarization at the LO position obtained in step 1. For TDD, only slots consisting of only UL symbols are under test. Calculate  $CarrLeak = \min(CarrLeak_{\theta}, CarrLeak_{\phi})$ .
10. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

NOTE 2: The purpose of the Uplink power control window is to ensure that the actual UE output power is no less than the target power level, and as close as possible to the target power level. The relationship between the Uplink power control window, the target power level and the corresponding possible actual UE Uplink power window is illustrated in Annex F.4.2.

**Table 6.4A.2.2.1.4.2-1: UE EIRP  $P_{req}$  (dBm) for carrier leakage**

Power Class	$P_{req}$ (dBm) for step 5
Power Class 1	17
Power Class 2	6
Power Class 3	0
Power Class 4	11

**Table 6.4A.2.2.1.4.2-2: Void.**

#### 6.4A.2.2.1.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with TRANSFORM\_PRECODER\_ENABLED condition in Table 4.6.3-118 PUSCH-Config.

#### 6.4A.2.2.1.5 Test requirement

For each of the  $n$  carrier leakage results derived in Annex E.3.1 for  $\theta$ - and  $\phi$ -polarization the minimum is calculated according to

$$CarrLeak = \min(CarrLeak_{\theta}, CarrLeak_{\phi}), \text{ where}$$

$$n = \begin{cases} 30, & \text{for 60 kHz SCS} \\ 60, & \text{for 120 kHz SCS} \end{cases}$$

Each of the  $n$  carrier leakage results CarrLeak shall not exceed the values in Table 6.4.2.2.5-1 for power class 1 Table 6.4.2.2.5-2 for power class 2, Table 6.4.2.2.5-3 for power class 3 and Table 6.4.2.2.5-4 for power class 4. Allocated RBs are not under test.

#### 6.4A.2.2.2 Carrier leakage for CA (3UL CA)

**Editor's note:** This clause is incomplete. The following aspects are either missing or not yet determined:

- This test is incomplete due to lack of RRC framework for LO position retrieval.
- Power window is TBD for power class 1, 2 and 4.
- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA is TBD.

##### 6.4A.2.2.2.1 Test purpose

Carrier leakage expresses itself as unmodulated sine wave with the carrier frequency. It is an interference of approximately constant amplitude and independent of the amplitude of the wanted signal. Carrier leakage interferes with the sub carriers at its position (if allocated), especially, when their amplitude is small.

The purpose of this test is to exercise the UE transmitter to verify its modulation quality in terms of carrier leakage.

##### 6.4A.2.2.2.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 3UL CA.

##### 6.4A.2.2.2.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.4A.2.2.0.

##### 6.4A.2.2.2.4 Test description

Same as in clause 6.4A.2.2.1.4 with the following exceptions:

- Instead of Table 6.4A.2.2.1.4.1-1 → use Table 6.4A.2.2.2.4-1.

**Table 6.4A.2.2.2.4-1: Intra-band Contiguous CA Test Configuration Table**

Default Conditions					
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes			Low and High range		
Test CC Combination setting (aggregated BW of the CA configuration) as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE			Lowest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1			Highest		
Test Parameters					
CA Configuration / Aggregated BW			Downlink Configuration	Uplink Configuration	
Test ID	CC & Mapping (NOTE 5)	CBW (MHz)	RB allocation	Modulation	RB allocation (NOTE 1)
1	PCC/CC1	Default	-	DFT-s-OFDM	Inner_Partial_Left for PC2, PC3, PC4 Inner_Partial_Left_Region2 for PC1
	SCC/CC2			QPSK	

SCC/CC3			
NOTE 1:	The specific configuration of each RF allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.		
NOTE 2:	CA Configuration Test cumulative aggregated BW settings are checked separately for each CA Configuration, which applicable aggregated channel bandwidths are specified in Table 5.5A.1-1.		
NOTE 3:	If the UE supports multiple CC Combinations in the CA Configuration with the same cumulative aggregated BW, only the combination with the lowest PCC ChBW is tested.		
NOTE 4:	When the signalled DC carrier position is at Inner_Partial_Left for PC2, PC3, PC4, use Inner_Partial_Right for UL RB allocation. When the signalled DC carrier position is in Inner_16RB_Left_Region2 for PC1, use Inner_16RB_Right_Region2 for UL RB allocation.		
NOTE 5:	PCC/CCi and SCC/CCj means PCC is on component carrier CCi and SCC is on component carrier CCj, with CCi or CCj frequencies defined in TS38.508-1 [10].		
NOTE 6:	Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: " <i>The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier</i> ".		

#### 6.4A.2.2.2.5 Test requirement

For each of the  $n$  carrier leakage results derived in Annex E.3.1 for  $\theta$ - and  $\phi$ -polarization the minimum is calculated according to

$\text{CarrLeak} = \min(\text{CarrLeak}_\theta, \text{CarrLeak}_\phi)$ , where

$$n = \begin{cases} 30, & \text{for 60 kHz SCS} \\ 60, & \text{for 120 kHz SCS} \end{cases}$$

Each of the  $n$  carrier leakage results CarrLeak shall not exceed the values in Table 6.4.2.2.5-1 for power class 1, Table 6.4.2.2.5-2 for power class 2, Table 6.4.2.2.5-3 for power class 3 and Table 6.4.2.2.5-4 for power class 4. Allocated RBs are not under test.

#### 6.4A.2.2.3 Carrier leakage for CA (4UL CA)

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- This test is incomplete due to lack of RRC framework for LO position retrieval.
- Power window is TBD for power class 1, 2 and 4.
- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA is TBD.

##### 6.4A.2.2.3.1 Test purpose

Carrier leakage expresses itself as unmodulated sine wave with the carrier frequency. It is an interference of approximately constant amplitude and independent of the amplitude of the wanted signal. Carrier leakage interferes with the sub carriers at its position (if allocated), especially, when their amplitude is small.

The purpose of this test is to exercise the UE transmitter to verify its modulation quality in terms of carrier leakage.

##### 6.4A.2.2.3.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 4UL CA.

##### 6.4A.2.2.3.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.4A.2.2.0.

##### 6.4A.2.2.3.4 Test description

Same as in clause 6.4A.2.2.1.4 with the following exceptions:

- Instead of Table 6.4A.2.2.1.4.1-1 → use Table 6.4A.2.2.3.4-1.

**Table 6.4A.2.2.3.4-1: Intra-band Contiguous CA Test Configuration Table**

Default Conditions					
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes			Low and High range		
Test CC Combination setting (aggregated BW of the CA configuration) as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE			Lowest aggregated BW		
Test SCS as specified in Table 5.3.5-1			Highest		
Test Parameters					
CA Configuration / Aggregated BW			Downlink Configuration	Uplink Configuration	
Test ID	CC & Mapping (NOTE 5)	CBW (MHz)	RB allocation	Modulation	RB allocation (NOTE 1)
1	PCC/CC1	50	-	DFT-s-OFDM QPSK	Inner_Partial_Left for PC2, PC3, PC4 Inner_Partial_Left_Region2 for PC1
	SCC/CC2	50		DFT-s-OFDM QPSK	
	SCC/CC3	50		DFT-s-OFDM QPSK	
	SCC/CC4	50		DFT-s-OFDM QPSK	
NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.					
NOTE 2: CA Configuration Test cumulative aggregated BW settings are checked separately for each CA Configuration, which applicable aggregated channel bandwidths are specified in Table 5.5A.1-1.					
NOTE 3: If the UE supports multiple CC Combinations in the CA Configuration with the same cumulative aggregated BW, only the combination with the lowest PCC ChBW is tested.					
NOTE 4: When the signalled DC carrier position is at Inner_Partial_Left for PC2, PC3, PC4, use Inner_Partial_Right for UL RB allocation. When the signalled DC carrier position is in Inner_Partial_Left_Region2 for PC1, use Inner_Partial_Right_Region2 for UL RB allocation.					
NOTE 5: PCC/CCi and SCC/CCj means PCC is on component carrier CCi and SCC is on component carrier CCj, with CCi or CCj frequencies defined in TS38.508-1 [10].					
NOTE 6: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".					

#### 6.4A.2.2.3.5 Test requirement

For each of the  $n$  carrier leakage results derived in Annex E.3.1 for  $\theta$ - and  $\varphi$ -polarization the minimum is calculated according to

$$\text{CarrLeak} = \min(\text{CarrLeak}_{\theta}, \text{CarrLeak}_{\varphi}), \text{ where}$$

$$n = \begin{cases} 30, & \text{for 60 kHz SCS} \\ 60, & \text{for 120 kHz SCS} \end{cases}$$

Each of the  $n$  total carrier leakage results CarrLeak shall not exceed the values in Table 6.4.2.2.5-1 for power class 1, Table 6.4.2.2.5-2 for power class 2, Table 6.4.2.2.5-3 for power class 3 and Table 6.4.2.2.5-4 for power class 4. Allocated RBs are not under test.

#### 6.4A.2.2.4 Carrier leakage for CA (5UL CA)

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- This test is incomplete due to lack of RRC framework for LO position retrieval.

- Power window is TBD for power class 1, 2 and 4.
- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA is TBD.

6.4A.2.2.4.1 Test purpose

Carrier leakage expresses itself as unmodulated sine wave with the carrier frequency. It is an interference of approximately constant amplitude and independent of the amplitude of the wanted signal. Carrier leakage interferes with the sub carriers at its position (if allocated), especially, when their amplitude is small.

The purpose of this test is to exercise the UE transmitter to verify its modulation quality in terms of carrier leakage.

6.4A.2.2.4.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 5UL CA.

6.4A.2.2.4.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.4A.2.2.0.

6.4A.2.2.4.4 Test description

Same as in clause 6.4A.2.2.1.4 with the following exceptions:

- Instead of Table 6.4A.2.2.1.4.1-1 → use Table 6.4A.2.2.4.4-1.

**Table 6.4A.2.2.4.4-1: Intra-band Contiguous CA Test Configuration Table**

Default Conditions					
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes			Low and High range		
Test CC Combination setting (aggregated BW of the CA configuration) as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE			Lowest aggregated BW		
Test SCS as specified in Table 5.3.5-1			Highest		
Test Parameters					
CA Configuration / Aggregated BW			Downlink Configuration	Uplink Configuration	
Test ID	CC & Mapping (NOTE 5)	CBW (MHz)	RB allocation	Modulation	RB allocation (NOTE 1)
1	PCC/CC1	50	-	DFT-s-OFDM QPSK	Inner_Partial_Left for PC2, PC3, PC4 Inner_Partial_Left_Region2 for PC1
	SCC/CC2	50		-	-
	SCC/CC3	50		-	-
	SCC/CC4	50		-	-
	SCC/CC5	50		-	-
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.					
NOTE 2: CA Configuration Test cumulative aggregated BW settings are checked separately for each CA Configuration, which applicable aggregated channel bandwidths are specified in Table 5.5A.1-1.					
NOTE 3: If the UE supports multiple CC Combinations in the CA Configuration with the same cumulative aggregated BW, only the combination with the lowest PCC ChBW is tested.					
NOTE 4: When the signalled DC carrier position is at Inner_Partial_Left for PC2, PC3, PC4, use Inner_Partial_Right for UL RB allocation. When the signalled DC carrier position is in Inner_Partial_Left_Region2 for PC1, use					

<p>Inner_Partial_Right_Region2 for UL RB allocation.</p> <p>NOTE 5: PCC/CC<sub>i</sub> and SCC/CC<sub>j</sub> means PCC is on component carrier CC<sub>i</sub> and SCC is on component carrier CC<sub>j</sub>, with CC<sub>i</sub> or CC<sub>j</sub> frequencies defined in TS 38.508-1 [10].</p> <p>NOTE 6: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".</p>
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#### 6.4A.2.2.4.5 Test requirement

For each of the  $n$  carrier leakage results derived in Annex E.3.1 for  $\theta$ - and  $\phi$ -polarization the minimum is calculated according to

$\text{CarrLeak} = \min(\text{CarrLeak}_\theta, \text{CarrLeak}_\phi)$ , where

$$n = \begin{cases} 30, & \text{for 60 kHz SCS} \\ 60, & \text{for 120 kHz SCS} \end{cases}$$

Each of the  $n$  carrier leakage results CarrLeak shall not exceed the values in Table 6.4.2.2.5-1 for power class 1, Table 6.4.2.2.5-2 for power class 2, Table 6.4.2.2.5-3 for power class 3 and Table 6.4.2.2.5-4 for power class 4. Allocated RBs are not under test.

#### 6.4A.2.2.5 Carrier leakage for CA (6UL CA)

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- This test is incomplete due to lack of RRC framework for LO position retrieval.
- Power window is TBD for power class 1, 2 and 4.
- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA is TBD.

#### 6.4A.2.2.5.1 Test purpose

Carrier leakage expresses itself as unmodulated sine wave with the carrier frequency. It is an interference of approximately constant amplitude and independent of the amplitude of the wanted signal. Carrier leakage interferes with the sub carriers at its position (if allocated), especially, when their amplitude is small.

The purpose of this test is to exercise the UE transmitter to verify its modulation quality in terms of carrier leakage.

#### 6.4A.2.2.5.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 6UL CA.

#### 6.4A.2.2.5.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.4A.2.2.0.

#### 6.4A.2.2.5.4 Test description

Same as in clause 6.4A.2.2.1.4 with the following exceptions:

- Instead of Table 6.4A.2.2.1.4.1-1 → use Table 6.4A.2.2.5.4-1.

**Table 6.4A.2.2.5.4-1: Intra-band Contiguous CA Test Configuration Table**

Default Conditions	
Test Environment as specified in TS 38.508-1 [10] subclause 4.1	Normal
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth	Low and High range



classes					
Test CC Combination setting (aggregated BW of the CA configuration) as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE			Lowest aggregated BW		
Test SCS as specified in Table 5.3.5-1			Highest		
Test Parameters					
CA Configuration / Aggregated BW			Downlink Configuration	Uplink Configuration	
Test ID	CC & Mapping (NOTE 5)	CBW (MHz)	RB allocation	Modulation	RB allocation (NOTE 1)
1	PCC/CC1	50	-	DFT-s-OFDM QPSK	Inner_Partial_Left for PC2, PC3, PC4 Inner_Partial_Left_Region2 for PC1
	SCC/CC2	50		-	-
	SCC/CC3	50		-	-
	SCC/CC4	50		-	-
	SCC/CC5	50		-	-
	SCC/CC6	50		-	-
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.					
NOTE 2: CA Configuration Test cumulative aggregated BW settings are checked separately for each CA Configuration, which applicable aggregated channel bandwidths are specified in Table 5.5A.1-1.					
NOTE 3: If the UE supports multiple CC Combinations in the CA Configuration with the same cumulative aggregated BW, only the combination with the lowest PCC ChBW is tested.					
NOTE 4: When the signalled DC carrier position is at Inner_Partial_Left for PC2, PC3, PC4, use Inner_Partial_Right for UL RB allocation. When the signalled DC carrier position is in Inner_Partial_Left_Region2 for PC1, use Inner_Partial_Right_Region2 for UL RB allocation.					
NOTE 5: PCC/CCi and SCC/CCj means PCC is on component carrier CCi and SCC is on component carrier CCj, with CCi or CCj frequencies defined in TS 38.508-1 [10].					
NOTE 6: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".					

6.4A.2.2.5.5 Test requirement

For each of the  $n$  carrier leakage results derived in Annex E.3.1 for  $\theta$ - and  $\phi$ -polarization the minimum is calculated according to

$$CarrLeak = \min(CarrLeak_{\theta}, CarrLeak_{\phi}), \text{ where}$$

$$n = \begin{cases} 30, & \text{for 60 kHz SCS} \\ 60, & \text{for 120 kHz SCS} \end{cases}$$

Each of the  $n$  carrier leakage results CarrLeak shall not exceed the values in Table 6.4.2.2.5-1 for power class 1, Table 6.4.2.2.5-2 for power class 2, Table 6.4.2.2.5-3 for power class 3 and Table 6.4.2.2.5-4 for power class 4. Allocated RBs are not under test.

6.4A.2.2.6 Carrier leakage for CA (7UL CA)

**Editor's note:** This clause is incomplete. The following aspects are either missing or not yet determined:

- This test is incomplete due to lack of RRC framework for LO position retrieval.
- Power window is TBD for power class 1, 2 and 4.

- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA is TBD.

6.4A.2.2.6.1 Test purpose

Carrier leakage expresses itself as unmodulated sine wave with the carrier frequency. It is an interference of approximately constant amplitude and independent of the amplitude of the wanted signal. Carrier leakage interferes with the sub carriers at its position (if allocated), especially, when their amplitude is small.

The purpose of this test is to exercise the UE transmitter to verify its modulation quality in terms of carrier leakage.

6.4A.2.2.6.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 7UL CA.

6.4A.2.2.6.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.4A.2.2.0.

6.4A.2.2.6.4 Test description

Same as in clause 6.4A.2.2.1.4 with the following exceptions:

- Instead of Table 6.4A.2.2.1.4.1-1 → use Table 6.4A.2.2.6.4-1.

**Table 6.4A.2.2.6.4-1: Intra-band Contiguous CA Test Configuration Table**

Default Conditions					
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes			Low and High range		
Test CC Combination setting (aggregated BW of the CA configuration) as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE			Lowest aggregated BW		
Test SCS as specified in Table 5.3.5-1			Highest		
Test Parameters					
CA Configuration / Aggregated BW			Downlink Configuration	Uplink Configuration	
Test ID	CC & Mapping (NOTE 5)	CBW (MHz)	RB allocation	Modulation	RB allocation (NOTE 1)
1	PCC/CC1	50	-	DFT-s-OFDM QPSK	Inner_Partial_Left for PC2, PC3, PC4 Inner_Partial_Left_Region2 for PC1
	SCC/CC2	50		-	-
	SCC/CC3	50		-	-
	SCC/CC4	50		-	-
	SCC/CC5	50		-	-
	SCC/CC6	50		-	-
	SCC/CC7	50		-	-
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.					
NOTE 2: CA Configuration Test cumulative aggregated BW settings are checked separately for each CA Configuration, which applicable aggregated channel bandwidths are specified in Table 5.5A.1-1.					
NOTE 3: If the UE supports multiple CC Combinations in the CA Configuration with the same cumulative aggregated BW, only the combination with the lowest PCC ChBW is tested.					

NOTE 4: When the signalled DC carrier position is at Inner_Partial_Left for PC2, PC3, PC4, use Inner_Partial_Right for UL RB allocation. When the signalled DC carrier position is in Inner_Partial_Left_Region2 for PC1, use Inner_Partial_Right_Region2 for UL RB allocation.
NOTE 5: PCC/CCi and SCC/CCj means PCC is on component carrier CCi and SCC is on component carrier CCj, with CCi or CCj frequencies defined in TS 38.508-1 [10].
NOTE 6: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".

#### 6.4A.2.2.6.5 Test requirement

For each of the  $n$  carrier leakage results derived in Annex E.3.1 for  $\theta$ - and  $\phi$ -polarization the minimum is calculated according to

$\text{CarrLeak} = \min(\text{CarrLeak}_\theta, \text{CarrLeak}_\phi)$ , where

$$n = \begin{cases} 30, & \text{for 60 kHz SCS} \\ 60, & \text{for 120 kHz SCS} \end{cases}$$

Each of the  $n$  carrier leakage results CarrLeak shall not exceed the values in Table 6.4.2.2.5-1 for power class 1, Table 6.4.2.2.5-2 for power class 2, Table 6.4.2.2.5-3 for power class 3 and Table 6.4.2.2.5-4 for power class 4. Allocated RBs are not under test.

#### 6.4A.2.2.7 Carrier leakage for CA (8UL CA)

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- This test is incomplete due to lack of RRC framework for LO position retrieval.
- Power window is TBD for power class 1, 2 and 4.
- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA is TBD.

##### 6.4A.2.2.7.1 Test purpose

Carrier leakage expresses itself as unmodulated sine wave with the carrier frequency. It is an interference of approximately constant amplitude and independent of the amplitude of the wanted signal. Carrier leakage interferes with the sub carriers at its position (if allocated), especially, when their amplitude is small.

The purpose of this test is to exercise the UE transmitter to verify its modulation quality in terms of carrier leakage.

##### 6.4A.2.2.7.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 8UL CA.

##### 6.4A.2.2.7.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.4A.2.2.0.

##### 6.4A.2.2.7.4 Test description

Same as in clause 6.4A.2.2.1.4 with the following exceptions:

- Instead of Table 6.4A.2.2.1.4.1-1 → use Table 6.4A.2.2.7.4-1.

**Table 6.4A.2.2.7.4-1: Intra-band Contiguous CA Test Configuration Table**

Default Conditions	
Test Environment as specified in TS 38.508-1 [10] subclause 4.1	Normal

Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes			Low and High range		
Test CC Combination setting (aggregated BW of the CA configuration) as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE			Lowest aggregated BW		
Test SCS as specified in Table 5.3.5-1			Highest		
Test Parameters					
CA Configuration / Aggregated BW			Downlink Configuration	Uplink Configuration	
Test ID	CC & Mapping (NOTE 5)	CBW (MHz)	RB allocation	Modulation	RB allocation (NOTE 1)
1	PCC/CC1	50	-	DFT-s-OFDM QPSK	Inner_Partial_Left for PC2, PC3, PC4 Inner_Partial_Left_Region2 for PC1
	SCC/CC2	50		-	-
	SCC/CC3	50		-	-
	SCC/CC4	50		-	-
	SCC/CC5	50		-	-
	SCC/CC6	50		-	-
	SCC/CC7	50		-	-
	SCC/CC8	50		-	-
<p>NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.</p> <p>NOTE 2: CA Configuration Test cumulative aggregated BW settings are checked separately for each CA Configuration, which applicable aggregated channel bandwidths are specified in Table 5.5A.1-1.</p> <p>NOTE 3: If the UE supports multiple CC Combinations in the CA Configuration with the same cumulative aggregated BW, only the combination with the lowest PCC ChBW is tested.</p> <p>NOTE 4: When the signalled DC carrier position is at Inner_Partial_Left for PC2, PC3, PC4, use Inner_Partial_Right for UL RB allocation. When the signalled DC carrier position is in Inner_Partial_Left_Region2 for PC1, use Inner_Partial_Right_Region2 for UL RB allocation.</p> <p>NOTE 5: PCC/CC<sub>i</sub> and SCC/CC<sub>j</sub> means PCC is on component carrier CC<sub>i</sub> and SCC is on component carrier CC<sub>j</sub>, with CC<sub>i</sub> or CC<sub>j</sub> frequencies defined in TS 38.508-1 [10].</p> <p>NOTE 6: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".</p>					

6.4A.2.2.7.5 Test requirement

For each of the *n* carrier leakage results derived in Annex E.3.1 for  $\theta$ - and  $\phi$ -polarization the minimum is calculated according to

$$CarrLeak = \min(CarrLeak_{\theta}, CarrLeak_{\phi}), \text{ where}$$

$$n = \begin{cases} 30, & \text{for 60 kHz SCS} \\ 60, & \text{for 120 kHz SCS} \end{cases}$$

Each of the *n* carrier leakage results CarrLeak shall not exceed the values in Table 6.4.2.2.5-1 for power class 1, Table 6.4.2.2.5-2 for power class 2, Table 6.4.2.2.5-3 for power class 3 and Table 6.4.2.2.5-4 for power class 4. Allocated RBs are not under test.

6.4A.2.3 In-band emissions for CA

Editor’s note: This test is incomplete due to lack of RRC framework for LO position retrieval

6.4A.2.3.0 Minimum conformance requirements

6.4A.2.3.0.1 General

Inband emission requirement is defined over the spectrum occupied by all configured UL and DL CCs. The measurement interval is as defined in section 6.4.2.4. The requirement is verified with the test metric of In-band emission (Link=TX beam peak direction, Meas=Link angle).

For intra-band contiguous carrier aggregation, the requirements in this clause apply with all component carriers active and with one single contiguous PRB allocation in one of uplink component carriers. The inband emission is defined as the interference falling into the non-allocated resource blocks for all component carriers.

6.4A.2.3.0.2 In-band emissions for power class 1

The relative in-band emission shall not exceed the values specified in Table 6.4A.2.3.0.2-1 for power class 1 UEs.

Table 6.4A.2.3.0.2-1: Requirements for in-band emissions for power class 1

Parameter description	Unit	Limit (NOTE 1)		Applicable Frequencies
General	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10} (EVM) - 5 \cdot \frac{(\Delta_{nB} - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right]$		Any non-allocated RB in allocated component carrier and not allocated component carriers (NOTE 2)
IQ Image	dB	-25	Output power > 27 dBm	Image frequencies (NOTES 2, 3)
		-20	Output power ≤ 27 dBm	
Carrier leakage	dBc	-25	Output power > 17 dBm	Carrier frequency (NOTES 4, 5)
		-20	4 dBm ≤ Output power ≤ 17 dBm	
<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB} - 25</math> dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 9.</p> <p>NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For Pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD.</p> <p>NOTE 3: Image frequencies for UL CA are specified in relation to either UL or DL carrier frequency.</p> <p>NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.</p> <p>NOTE 5: The applicable frequencies for this limit are those that are enclosed in the RBs containing the DC frequency, or in the two RBs immediately adjacent to the DC frequency but excluding any allocated RB.</p> <p>NOTE 6: <math>L_{CRB}</math> is the Transmission Bandwidth for kth allocated component carrier (see Figure 5.3.1-1).</p> <p>NOTE 7: EVM is the limit for the modulation format used in the allocated RBs.</p> <p>NOTE 8: <math>\Delta_{nB}</math> is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g. <math>\Delta_{nB} = 1</math> or <math>\Delta_{nB} = -1</math> for the first adjacent RB outside of the allocated bandwidth), and may take non-integer values when the carrier spacing between the CCs is not a multiple of RB.</p> <p>NOTE 9: <math>P_{RB}</math> is the transmitted power per allocated RB, measured in dBm.</p> <p>NOTE 10: All powers are EIRP in beam peak direction.</p>				

6.4A.2.3.0.3 In-band emissions for power class 2

The relative in-band emission shall not exceed the values specified in Table 6.4A.2.3.0.3-1 for power class 2.

Table 6.4A.2.3.0.3-1: Requirements for in-band emissions for power class 2

Parameter description	Unit	Limit (NOTE 1)	Applicable Frequencies
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<b>General</b>	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10} (EVM) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right]$		Any non-allocated RB in allocated component carrier and not allocated component carriers (NOTE 2)
<b>IQ Image</b>	dB	-25	Output power > 16 dBm	Image frequencies (NOTES 2, 3)
		-20	Output power ≤ 16 dBm	
<b>Carrier leakage</b>	dBc	-25	Output power > 6 dBm	Carrier frequency (NOTES 4, 5)
		-20	-13 dBm ≤ Output power ≤ 6 dBm	
<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB} - 25</math> dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 9.</p> <p>NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For Pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD.</p> <p>NOTE 3: Image frequencies for UL CA are specified in relation to either UL or DL carrier frequency.</p> <p>NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.</p> <p>NOTE 5: The applicable frequencies for this limit are those that are enclosed in the RBs containing the DC frequency, or in the two RBs immediately adjacent to the DC frequency but excluding any allocated RB.</p> <p>NOTE 6: <math>L_{CRB}</math> is the Transmission Bandwidth for kth allocated component carrier (see Figure 5.3.1-1).</p> <p>NOTE 7: EVM s the limit for the modulation format used in the allocated RBs.</p> <p>NOTE 8: <math>\Delta_{RB}</math> is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g. <math>\Delta_{RB} = 1</math> or <math>\Delta_{RB} = -1</math> for the first adjacent RB outside of the allocated bandwidth), and may take non-integer values when the carrier spacing between the CCs is not a multiple of RB.</p> <p>NOTE 9: <math>P_{RB}</math> is the transmitted power per allocated RB, measured in dBm.</p> <p>NOTE 10: All powers are EIRP in beam peak direction.</p>				

6.4A.2.3.0.4 In-band emissions for power class 3

The relative in-band emission shall not exceed the values specified in Table 6.4A.2.3.0.4-1 for power class 3 UEs.

**Table 6.4A.2.3.0.4-1: Requirements for in-band emissions for power class 3**

Parameter description	Unit	Limit (NOTE 1)		Applicable Frequencies
<b>General</b>	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10} (EVM) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right]$		Any non-allocated RB in allocated component carrier and not allocated component carriers (NOTE 2)
<b>IQ Image</b>	dB	-25	Output power > 10 dBm	Image frequencies (NOTES 2, 3)
		-20	Output power ≤ 10 dBm	
<b>Carrier leakage</b>	dBc	-25	Output power > 0 dBm	Carrier frequency (NOTES 4, 5)
		-20	-13 dBm ≤ Output power ≤ 0 dBm	
<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB} - 25</math> dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 9.</p> <p>NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For Pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD.</p> <p>NOTE 3: Image frequencies for UL CA are specified in relation to either UL or DL carrier frequency.</p> <p>NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.</p> <p>NOTE 5: The applicable frequencies for this limit are those that are enclosed in the RBs containing the DC frequency, or in the two RBs immediately adjacent to the DC frequency but excluding any allocated RB.</p> <p>NOTE 6: <math>L_{CRB}</math> is the Transmission Bandwidth for kth allocated component carrier (see Figure 5.3.1-1).</p> <p>NOTE 7: EVM s the limit for the modulation format used in the allocated RBs.</p> <p>NOTE 8: <math>\Delta_{RB}</math> is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g. <math>\Delta_{RB} = 1</math> or</p>				

$\Delta_{RB} = -1$  for the first adjacent RB outside of the allocated bandwidth), and may take non-integer values when the carrier spacing between the CCs is not a multiple of RB.  
 NOTE 9:  $P_{RB}$  is the transmitted power per allocated RB, measured in dBm.  
 NOTE 10: All powers are EIRP in beam peak direction.

6.4A.2.3.0.5 In-band emissions for power class 4

The relative in-band emission shall not exceed the values specified in Table 6.4A.2.3.0.5-1 for power class 4 UEs.

**Table 6.4A.2.3.0.5-1: Requirements for in-band emissions for power class 4**

Parameter description	Unit	Limit (NOTE 1)		Applicable Frequencies
General	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10} (\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right]$		Any non-allocated RB in allocated component carrier and not allocated component carriers (NOTE 2)
IQ Image	dB	-25	Output power > 21 dBm	Image frequencies (NOTES 2, 3)
		-20	Output power ≤ 21 dBm	
Carrier leakage	dBc	-25	Output power > 11 dBm	Carrier frequency (NOTES 4, 5)
		-20	-13 dBm ≤ Output power ≤ 11 dBm	
NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of ( $P_{RB} - 25$ dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. $P_{RB}$ is defined in NOTE 9. NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD. NOTE 3: Image frequencies for UL CA are specified in relation to either UL or DL carrier frequency. NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs. NOTE 5: The applicable frequencies for this limit are those that are enclosed in the RBs containing the DC frequency, or in the two RBs immediately adjacent to the DC frequency but excluding any allocated RB. NOTE 6: $L_{CRB}$ is the Transmission Bandwidth for kth allocated component carrier (see Figure 5.3.1-1). NOTE 7: EVM is the limit for the modulation format used in the allocated RBs. NOTE 8: $\Delta_{RB}$ is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g. $\Delta_{RB} = 1$ or $\Delta_{RB} = -1$ for the first adjacent RB outside of the allocated bandwidth), and may take non-integer values when the carrier spacing between the CCs is not a multiple of RB. NOTE 9: $P_{RB}$ is the transmitted power per allocated RB, measured in dBm. NOTE 10: All powers are EIRP in beam peak direction.				

6.4A.2.3.1 In-band emissions for CA (2UL CA)

Editor’s note: This clause is incomplete. The following aspects are either missing or not yet determined:

- The test procedure is incomplete due to that power window for CA is TBD
- Measurement Uncertainty and Test Tolerance are FFS.
- Testing of the general in-band emission requirement and if yes at which UE Tx power level and with which relaxation applied to the requirement is FFS.
- TP analysis is FFS

6.4A.2.3.1.1 Test purpose

The in-band emissions are a measure of the interference falling into the non-allocated resources blocks.

The purpose of this test is to exercise the UE transmitter to verify its modulation quality in terms of in-band emissions.

## 6.4A.2.3.1.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 2UL CA.

## 6.4A.2.3.1.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.4A.2.3.0.

## 6.4A.2.3.1.4 Test description

## 6.4A.2.3.1.4.1 Initial condition

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, and CC combinations based on NR operating bands specified in clause 5.5A. All of these configurations shall be tested with applicable test parameters for each channel bandwidth and subcarrier spacing, are shown in Table 6.4A.2.3.1.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.4A.2.3.1.4.1-1: Test Configuration Table**

Default Conditions					
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.			Low and High range		
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.			Lowest aggregated BW of the CA configuration Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1.			Lowest		
Test Parameters					
CA Configuration / Aggregated BW			Downlink Configuration	Uplink Configuration	
Test ID	CC & Mapping	ChBw(MHz)	RB allocation	Modulation	RB allocation (NOTE 1)
1	PCC	Default	-	DFT-s-OFDM PI/2 BPSK	Inner_Partial_Left for PC2, PC3, PC4 Inner_Partial_Left_Region2 for PC1
	SCC1			-	-
2	PCC			DFT-s-OFDM PI/2 BPSK	Inner_Partial_Right for PC2, PC3, PC4 Inner_Partial_Right_Region2 for PC1
	SCC1			-	-
3	PCC			CP-OFDM QPSK	Inner_Partial_Left for PC2, PC3, PC4 Inner_Partial_Left_Region2 for PC1
	SCC1			-	-
4	PCC			CP-OFDM QPSK	Inner_Partial_Right for PC2, PC3, PC4 Inner_Partial_Right_Region2 for PC1
	SCC1			-	-
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.					



NOTE 2: CA Configuration Test cumulative aggregated BW settings are checked separately for each CA Configuration, which applicable aggregated channel bandwidths are specified in Table 5.5A.1-1.

NOTE 3: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "*The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier*".

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals for PCC are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement channels are set according to Table 6.4A.2.3.1.4.1-1.
5. Propagation conditions are set according to Annex B.0
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity NR, Connected without release On, Test Mode On and Test Loop Function On according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.4A.2.3.1.4.3

#### 6.4A.2.3.1.4.2 Test procedure

1. Retrieve the LO position from the parameter txDirectCurrentLocation in UplinkTxDirectCurrent IE.
2. Configure SCC according to Annex C.0, C.1 and C.3.0 for all downlink physical channels.
3. The SS shall configure SCC as per TS 38.508-1 [10] clause 5.5.1. Procedure to configure SCC(s) for NR RF CA testing. Message contents are defined in clause 6.4A.2.3.1.4.3.
4. SS activates SCC by sending the activation MAC CE (Refer TS 38.321 [28], clauses 5.9, 6.1.3.10). Wait for at least 2 seconds (Refer TS 38.133[25], clause 9.3).
5. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.4A.2.3.1.4.1-1. Since the UE has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC.
6. Set the UE in the Inband Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 2) for the UE Tx beam selection to complete.
7. Send the appropriate TPC commands in the uplink scheduling information to the UE until UE output power is  $P_{req} + P_W \pm P_W$ , where  $P_{req}$  is the power level specified in Table 6.4A.2.3.1.4.2-1 according to the power class with power ID = 1.  $P_W$  is the power window according to Table 6.4A.2.3.1.4.2-2 for the carrier frequency  $f$  and the channel bandwidth BW. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 2) for the UE Tx beam selection to complete.
8. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition TxRx.
9. Measure In-band emission  $IE_\theta$ ,  $IE_\phi$  on PCC using Global In-Channel Tx-Test (Annex E) for the  $\theta$ - and  $\phi$ -polarizations, respectively. Measure power spectral density on the SCC. For TDD, only slots consisting of only UL symbols are under test. Calculate  $IE = IE_\theta + IE_\phi$ , where the calculation is based on linear power ratios.
10. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.
11. Repeat steps 6 through 10 until In-band emissions have been measured for all power IDs in Table 6.4A.2.3.1.4.2-1.

NOTE 1: When switching to DFT-s-OFDM waveform, as specified in Table 6.4A.2.3.1.4.1-1, send an NR RRCReconfiguration message according to TS 38.508-1 [10] clause 4.6.3 Table 4.6.3-118 PUSCH-Config with TRANSFORM\_PRECODER\_ENABLED condition.

NOTE 2: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

**Table 6.4A.2.3.1.4.2-1: Parameters for In-band emissions**

Power ID	Unit	Level for power class 1	Level for power class 2	Level for power class 3	Level for power class 4
1	dBm	27	16	10	21
2	dBm	17	6	0	11

**Table 6.4A.2.3.1.4.2-2: Power Window (dB) for In-band emissions**

FFS

6.4A.2.3.1.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6.

6.4A.2.3.1.5 Test requirement

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4A.2.3.1.5-1 for power class 1 UEs.

**Table 6.4A.2.3.1.5-1: Test Requirements for in-band emissions for power class 1**

Parameter description	Unit	Limit (NOTE 1)		Applicable Frequencies
General	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10} (EVM) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right]_{+TT}$		Any non-allocated RB in allocated component carrier and not allocated component carriers (NOTE 2)
IQ Image	dB	-25+TT	Output power > 27 dBm	Image frequencies (NOTES 2, 3)
		-20+TT	Output power ≤ 27 dBm	
Carrier leakage	dBc	-25+TT	Output power > 17 dBm	Carrier frequency (NOTES 4, 5)
		-20+TT	4 dBm ≤ Output power ≤ 17 dBm	
<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB} - 25</math> dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 9.</p> <p>NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For Pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD.</p> <p>NOTE 3: Image frequencies for UL CA are specified in relation to either UL or DL carrier frequency.</p> <p>NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.</p> <p>NOTE 5: The applicable frequencies for this limit are those that are enclosed in the RBs containing the DC frequency, or in the two RBs immediately adjacent to the DC frequency but excluding any allocated RB.</p> <p>NOTE 6: <math>L_{CRB}</math> is the Transmission Bandwidth for kth allocated component carrier (see Figure 5.3.1-1).</p> <p>NOTE 7: EVM is the limit for the modulation format used in the allocated RBs.</p> <p>NOTE 8: <math>\Delta_{RB}</math> is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g. <math>\Delta_{RB} = 1</math> or <math>\Delta_{RB} = -1</math> for the first adjacent RB outside of the allocated bandwidth), and may take non-integer values when the carrier spacing between the CCs is not a multiple of RB.</p> <p>NOTE 9: <math>P_{RB}</math> is the transmitted power per allocated RB, measured in dBm.</p> <p>NOTE 10: All powers are EIRP in beam peak direction.</p>				

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4A.2.3.1.5-2 for power class 2 UEs.

**Table 6.4A.2.3.1.5-2: Test Requirements for in-band emissions for power class 2**

Parameter description	Unit	Limit (NOTE 1)	Applicable Frequencies
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<b>General</b>	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10} (EVM) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right]_{+TT}$		Any non-allocated RB in allocated component carrier and not allocated component carriers (NOTE 2)
<b>IQ Image</b>	dB	-25+TT	Output power > 16 dBm	Image frequencies (NOTES 2, 3)
		-20+TT	Output power ≤ 16 dBm	
<b>Carrier leakage</b>	dBc	-25+TT	Output power > 6 dBm	Carrier frequency (NOTES 4, 5)
		-20+TT	-13 dBm ≤ Output power ≤ 6 dBm	
<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB} - 25</math> dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 9.</p> <p>NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For Pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD.</p> <p>NOTE 3: Image frequencies for UL CA are specified in relation to either UL or DL carrier frequency.</p> <p>NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.</p> <p>NOTE 5: The applicable frequencies for this limit are those that are enclosed in the RBs containing the DC frequency, or in the two RBs immediately adjacent to the DC frequency but excluding any allocated RB.</p> <p>NOTE 6: <math>L_{CRB}</math> is the Transmission Bandwidth for kth allocated component carrier (see Figure 5.3.1-1).</p> <p>NOTE 7: EVM is the limit for the modulation format used in the allocated RBs.</p> <p>NOTE 8: <math>\Delta_{RB}</math> is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g. <math>\Delta_{RB} = 1</math> or <math>\Delta_{RB} = -1</math> for the first adjacent RB outside of the allocated bandwidth), and may take non-integer values when the carrier spacing between the CCs is not a multiple of RB.</p> <p>NOTE 9: <math>P_{RB}</math> is the transmitted power per allocated RB, measured in dBm.</p> <p>NOTE 10: All powers are EIRP in beam peak direction.</p>				

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4A.2.3.1.5-3 for power class 3 UEs.

**Table 6.4A.2.3.1.5-3: Test Requirements for in-band emissions for power class 3**

Parameter description	Unit	Limit (NOTE 1)		Applicable Frequencies
<b>General</b>	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10} (EVM) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right]_{+TT}$		Any non-allocated RB in allocated component carrier and not allocated component carriers (NOTE 2)
<b>IQ Image</b>	dB	-25+TT	Output power > 10 dBm	Image frequencies (NOTES 2, 3)
		-20+TT	Output power ≤ 10 dBm	
<b>Carrier leakage</b>	dBc	-25+TT	Output power > 0 dBm	Carrier frequency (NOTES 4, 5)
		-20+TT	-13 dBm ≤ Output power ≤ 0 dBm	
<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB} - 25</math> dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 9.</p> <p>NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For Pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD.</p> <p>NOTE 3: Image frequencies for UL CA are specified in relation to either UL or DL carrier frequency.</p> <p>NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.</p> <p>NOTE 5: The applicable frequencies for this limit are those that are enclosed in the RBs containing the DC frequency, or in the two RBs immediately adjacent to the DC frequency but excluding any allocated RB.</p> <p>NOTE 6: <math>L_{CRB}</math> is the Transmission Bandwidth for kth allocated component carrier (see Figure 5.3.1-1).</p> <p>NOTE 7: EVM is the limit for the modulation format used in the allocated RBs.</p> <p>NOTE 8: <math>\Delta_{RB}</math> is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g. <math>\Delta_{RB} = 1</math> or <math>\Delta_{RB} = -1</math> for the first adjacent RB outside of the allocated bandwidth), and may take non-integer values when the carrier spacing between the CCs is not a multiple of RB.</p> <p>NOTE 9: <math>P_{RB}</math> is the transmitted power per allocated RB, measured in dBm.</p>				

NOTE 10: All powers are EIRP in beam peak direction.

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4A.2.3.1.5-4 for power class 4 UEs.

**Table 6.4A.2.3.1.5-4: Test Requirements for in-band emissions for power class 4**

Parameter description	Unit	Limit (NOTE 1)		Applicable Frequencies
General	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10} (EVM) - 5 \cdot \frac{(\Delta_{RB} - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right] + TT$		Any non-allocated RB in allocated component carrier and not allocated component carriers (NOTE 2)
IQ Image	dB	-25+TT	Output power > 21 dBm	Image frequencies (NOTES 2, 3)
		-20+TT	Output power ≤ 21 dBm	
Carrier leakage	dBc	-25+TT	Output power > 11 dBm	Carrier frequency (NOTES 4, 5)
		-20+TT	-13 dBm ≤ Output power ≤ 11 dBm	
<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB} - 25</math> dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 9.</p> <p>NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD.</p> <p>NOTE 3: Image frequencies for UL CA are specified in relation to either UL or DL carrier frequency.</p> <p>NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.</p> <p>NOTE 5: The applicable frequencies for this limit are those that are enclosed in the RBs containing the DC frequency, or in the two RBs immediately adjacent to the DC frequency but excluding any allocated RB.</p> <p>NOTE 6: <math>L_{CRB}</math> is the Transmission Bandwidth for kth allocated component carrier (see Figure 5.3.1-1).</p> <p>NOTE 7: EVM is the limit for the modulation format used in the allocated RBs.</p> <p>NOTE 8: <math>\Delta_{RB}</math> is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g. <math>\Delta_{RB} = 1</math> or <math>\Delta_{RB} = -1</math> for the first adjacent RB outside of the allocated bandwidth), and may take non-integer values when the carrier spacing between the CCs is not a multiple of RB.</p> <p>NOTE 9: <math>P_{RB}</math> is the transmitted power per allocated RB, measured in dBm.</p> <p>NOTE 10: All powers are EIRP in beam peak direction.</p>				

6.4A.2.3.2 In-band emissions for CA (3UL CA)

Editor’s note: This clause is incomplete. The following aspects are either missing or not yet determined:

- The test procedure is incomplete due to that power window for CA is TBD
- Measurement Uncertainty and Test Tolerance are FFS.
- Testing of the general in-band emission requirement and if yes at which UE Tx power level and with which relaxation applied to the requirement is FFS.
- TP analysis is FFS

6.4A.2.3.2.1 Test purpose

The in-band emissions are a measure of the interference falling into the non-allocated resources blocks.

The purpose of this test is to exercise the UE transmitter to verify its modulation quality in terms of in-band emissions.

6.4A.2.3.2.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 3UL CA.

6.4A.2.3.2.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.4A.2.3.0.

6.4A.2.3.2.4 Test description

Same as in clause 6.4A.2.3.1.4 with following exceptions:

- Instead of Table 6.4A.2.3.1.4.1-1 → use Table 6.4A.2.3.2.4-1.

**Table 6.4A.2.3.2.4-1: Test Configuration Table for 3UL CA**

Default Conditions					
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.			Low and High range		
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.			Lowest aggregated BW of the CA configuration Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1.			Lowest		
Test Parameters					
CA Configuration / Aggregated BW			Downlink Configuration	Uplink Configuration	
Test ID	CC & Mapping	ChBw(MHz)	RB allocation	Modulation	RB allocation (NOTE 1)
1	PCC	Default	-	DFT-s-OFDM PI/2 BPSK	Inner_Partial_Left for PC2, PC3, PC4 Inner_Partial_Left_Region2 for PC1
	SCC1			-	-
	SCC2			-	-
2	PCC			DFT-s-OFDM PI/2 BPSK	Inner_Partial_Right for PC2, PC3, PC4 Inner_Partial_Right_Region2 for PC1
	SCC1			-	-
	SCC2			-	-
3	PCC			CP-OFDM QPSK	Inner_Partial_Left for PC2, PC3, PC4 Inner_Partial_Left_Region2 for PC1
	SCC1			-	-
	SCC2			-	-
4	PCC			CP-OFDM QPSK	Inner_Partial_Right for PC2, PC3, PC4 Inner_Partial_Right_Region2 for PC1
	SCC1			-	-
	SCC2			-	-
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.					
NOTE 2: CA Configuration Test cumulative aggregated BW settings are checked separately for each CA Configuration, which applicable aggregated channel bandwidths are specified in Table 5.5A.1-1.					
NOTE 3: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".					

6.4A.2.3.2.5 Test requirement

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4A.2.3.2.5-1 for power class 1 UEs.

Table 6.4A.2.3.2.5-1: Test Requirements for in-band emissions for power class 1

Parameter description	Unit	Limit (NOTE 1)	Applicable Frequencies
General	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10} (\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right] + \text{TT}$	Any non-allocated RB in allocated component carrier and not allocated component carriers (NOTE 2)
IQ Image	dB	-25+TT	Output power > 27 dBm
		-20+TT	Output power ≤ 27 dBm
Carrier leakage	dBc	-25+TT	Output power > 17 dBm
		-20+TT	4 dBm ≤ Output power ≤ 17 dBm
<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB} - 25</math> dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 9.</p> <p>NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For Pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD.</p> <p>NOTE 3: Image frequencies for UL CA are specified in relation to either UL or DL carrier frequency.</p> <p>NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.</p> <p>NOTE 5: The applicable frequencies for this limit are those that are enclosed in the RBs containing the DC frequency, or in the two RBs immediately adjacent to the DC frequency but excluding any allocated RB.</p> <p>NOTE 6: <math>L_{CRB}</math> is the Transmission Bandwidth for kth allocated component carrier (see Figure 5.3.1-1).</p> <p>NOTE 7: EVM is the limit for the modulation format used in the allocated RBs.</p> <p>NOTE 8: <math>\Delta_{RB}</math> is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g. <math>\Delta_{RB} = 1</math> or <math>\Delta_{RB} = -1</math> for the first adjacent RB outside of the allocated bandwidth), and may take non-integer values when the carrier spacing between the CCs is not a multiple of RB.</p> <p>NOTE 9: <math>P_{RB}</math> is the transmitted power per allocated RB, measured in dBm.</p> <p>NOTE 10: All powers are EIRP in beam peak direction.</p>			

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4A.2.3.2.5-2 for power class 2 UEs.

Table 6.4A.2.3.2.5-2: Test Requirements for in-band emissions for power class 2

Parameter description	Unit	Limit (NOTE 1)	Applicable Frequencies
General	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10} (\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right] + \text{TT}$	Any non-allocated RB in allocated component carrier and not allocated component carriers (NOTE 2)
IQ Image	dB	-25+TT	Output power > 16 dBm
		-20+TT	Output power ≤ 16 dBm
Carrier leakage	dBc	-25+TT	Output power > 6 dBm
		-20+TT	-13 dBm ≤ Output power ≤ 6 dBm
<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB} - 25</math> dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 9.</p> <p>NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For Pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD.</p> <p>NOTE 3: Image frequencies for UL CA are specified in relation to either UL or DL carrier frequency.</p>			

NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.

NOTE 5: The applicable frequencies for this limit are those that are enclosed in the RBs containing the DC frequency, or in the two RBs immediately adjacent to the DC frequency but excluding any allocated RB.

NOTE 6:  $L_{CRB}$  is the Transmission Bandwidth for kth allocated component carrier (see Figure 5.3.1-1).

NOTE 7: EVM is the limit for the modulation format used in the allocated RBs.

NOTE 8:  $\Delta_{RB}$  is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g.  $\Delta_{RB} = 1$  or  $\Delta_{RB} = -1$  for the first adjacent RB outside of the allocated bandwidth), and may take non-integer values when the carrier spacing between the CCs is not a multiple of RB.

NOTE 9:  $P_{RB}$  is the transmitted power per allocated RB, measured in dBm.

NOTE 10: All powers are EIRP in beam peak direction.

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4A.2.3.2.5-3 for power class 3 UEs.

**Table 6.4A.2.3.2.5-3: Test Requirements for in-band emissions for power class 3**

Parameter description	Unit	Limit (NOTE 1)	Applicable Frequencies
General	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10}(\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right] + \text{TT}$	Any non-allocated RB in allocated component carrier and not allocated component carriers (NOTE 2)
IQ Image	dB	-25+TT	Image frequencies (NOTES 2, 3)
		Output power > 10 dBm	
Carrier leakage	dBc	-20+TT	Carrier frequency (NOTES 4, 5)
		Output power > 0 dBm	
		-13 dBm ≤ Output power ≤ 0 dBm	

NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of ( $P_{RB} - 25$  dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply.  $P_{RB}$  is defined in NOTE 9.

NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For Pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD.

NOTE 3: Image frequencies for UL CA are specified in relation to either UL or DL carrier frequency.

NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.

NOTE 5: The applicable frequencies for this limit are those that are enclosed in the RBs containing the DC frequency, or in the two RBs immediately adjacent to the DC frequency but excluding any allocated RB.

NOTE 6:  $L_{CRB}$  is the Transmission Bandwidth for kth allocated component carrier (see Figure 5.3.1-1).

NOTE 7: EVM is the limit for the modulation format used in the allocated RBs.

NOTE 8:  $\Delta_{RB}$  is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g.  $\Delta_{RB} = 1$  or  $\Delta_{RB} = -1$  for the first adjacent RB outside of the allocated bandwidth), and may take non-integer values when the carrier spacing between the CCs is not a multiple of RB.

NOTE 9:  $P_{RB}$  is the transmitted power per allocated RB, measured in dBm.

NOTE 10: All powers are EIRP in beam peak direction.

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4A.2.3.2.5-4 for power class 4 UEs.

**Table 6.4A.2.3.2.5-4: Test Requirements for in-band emissions for power class 4**

Parameter description	Unit	Limit (NOTE 1)	Applicable Frequencies
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<b>General</b>	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10} (\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right] + \text{TT}$		Any non-allocated RB in allocated component carrier and not allocated component carriers (NOTE 2)
<b>IQ Image</b>	dB	-25+TT	Output power > 21 dBm	Image frequencies (NOTES 2, 3)
		-20+TT	Output power ≤ 21 dBm	
<b>Carrier leakage</b>	dBc	-25+TT	Output power > 11 dBm	Carrier frequency (NOTES 4, 5)
		-20+TT	-13 dBm ≤ Output power ≤ 11 dBm	
<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB} - 25</math> dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 9.</p> <p>NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD.</p> <p>NOTE 3: Image frequencies for UL CA are specified in relation to either UL or DL carrier frequency.</p> <p>NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.</p> <p>NOTE 5: The applicable frequencies for this limit are those that are enclosed in the RBs containing the DC frequency, or in the two RBs immediately adjacent to the DC frequency but excluding any allocated RB.</p> <p>NOTE 6: <math>L_{CRB}</math> is the Transmission Bandwidth for kth allocated component carrier (see Figure 5.3.1-1).</p> <p>NOTE 7: EVM is the limit for the modulation format used in the allocated RBs.</p> <p>NOTE 8: <math>\Delta_{RB}</math> is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g. <math>\Delta_{RB} = 1</math> or <math>\Delta_{RB} = -1</math> for the first adjacent RB outside of the allocated bandwidth), and may take non-integer values when the carrier spacing between the CCs is not a multiple of RB.</p> <p>NOTE 9: <math>P_{RB}</math> is the transmitted power per allocated RB, measured in dBm.</p> <p>NOTE 10: All powers are EIRP in beam peak direction.</p>				

### 6.4A.2.3.3 In-band emissions for CA (4UL CA)

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- The test procedure is incomplete due to that power window for CA is TBD
- Measurement Uncertainty and Test Tolerance are FFS.
- Testing of the general in-band emission requirement and if yes at which UE Tx power level and with which relaxation applied to the requirement is FFS.
- TP analysis is FFS

#### 6.4A.2.3.3.1 Test purpose

The in-band emissions are a measure of the interference falling into the non-allocated resources blocks.

The purpose of this test is to exercise the UE transmitter to verify its modulation quality in terms of in-band emissions.

#### 6.4A.2.3.3.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 4UL CA.

#### 6.4A.2.3.3.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.4A.2.3.0.

#### 6.4A.2.3.3.4 Test description

Same as in clause 6.4A.2.3.1.4 with following exceptions:



- Instead of Table 6.4A.2.3.1.4.1-1 → use Table 6.4A.2.3.3.4-1.

**Table 6.4A.2.3.3.4-1: Test Configuration Table for 4UL CA**

Default Conditions					
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.			Low and High range		
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.			Lowest aggregated BW of the CA configuration Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1.			Lowest		
Test Parameters					
CA Configuration / Aggregated BW			Downlink Configuration	Uplink Configuration	
Test ID	CC & Mapping	ChBw(MHz)	RB allocation	Modulation	RB allocation (NOTE 1)
1	PCC	Default	-	DFT-s-OFDM PI/2 BPSK	Inner_Partial_Left for PC2, PC3, PC4 Inner_Partial_Left_Region2 for PC1
	SCC1			-	-
	SCC2			-	-
	SCC3			-	-
2	PCC			DFT-s-OFDM PI/2 BPSK	Inner_Partial_Right for PC2, PC3, PC4 Inner_Partial_Right_Region2 for PC1
	SCC1			-	-
	SCC2			-	-
	SCC3			-	-
3	PCC			CP-OFDM QPSK	Inner_Partial_Left for PC2, PC3, PC4 Inner_Partial_Left_Region2 for PC1
	SCC1			-	-
	SCC2			-	-
	SCC3			-	-
4	PCC			CP-OFDM QPSK	Inner_Partial_Right for PC2, PC3, PC4 Inner_Partial_Right_Region2 for PC1
	SCC1			-	-
	SCC2			-	-
	SCC3			-	-
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.					
NOTE 2: CA Configuration Test cumulative aggregated BW settings are checked separately for each CA Configuration, which applicable aggregated channel bandwidths are specified in Table 5.5A.1-1.					
NOTE 3: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".					

6.4A.2.3.3.5 Test requirement

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4A.2.3.3.5-1 for power class 1 UEs.

**Table 6.4A.2.3.3.5-1: Test Requirements for in-band emissions for power class 1**

Parameter	Unit	Limit (NOTE 1)	Applicable
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description			Frequencies
General	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10} (\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right] + \text{TT}$	Any non-allocated RB in allocated component carrier and not allocated component carriers (NOTE 2)
IQ Image	dB	-25+TT	Output power > 27 dBm
		-20+TT	Output power ≤ 27 dBm
Carrier leakage	dBc	-25+TT	Output power > 17 dBm
		-20+TT	4 dBm ≤ Output power ≤ 17 dBm
<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB} - 25</math> dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 9.</p> <p>NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For Pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD.</p> <p>NOTE 3: Image frequencies for UL CA are specified in relation to either UL or DL carrier frequency.</p> <p>NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.</p> <p>NOTE 5: The applicable frequencies for this limit are those that are enclosed in the RBs containing the DC frequency, or in the two RBs immediately adjacent to the DC frequency but excluding any allocated RB.</p> <p>NOTE 6: <math>L_{CRB}</math> is the Transmission Bandwidth for kth allocated component carrier (see Figure 5.3.1-1).</p> <p>NOTE 7: EVM is the limit for the modulation format used in the allocated RBs.</p> <p>NOTE 8: <math>\Delta_{RB}</math> is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g. <math>\Delta_{RB} = 1</math> or <math>\Delta_{RB} = -1</math> for the first adjacent RB outside of the allocated bandwidth), and may take non-integer values when the carrier spacing between the CCs is not a multiple of RB.</p> <p>NOTE 9: <math>P_{RB}</math> is the transmitted power per allocated RB, measured in dBm.</p> <p>NOTE 10: All powers are EIRP in beam peak direction.</p>			

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4A.2.3.3.5-2 for power class 2 UEs.

**Table 6.4A.2.3.3.5-2: Test Requirements for in-band emissions for power class 2**

Parameter description	Unit	Limit (NOTE 1)	Applicable Frequencies
General	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10} (\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right] + \text{TT}$	Any non-allocated RB in allocated component carrier and not allocated component carriers (NOTE 2)
IQ Image	dB	-25+TT	Output power > 16 dBm
		-20+TT	Output power ≤ 16 dBm
Carrier leakage	dBc	-25+TT	Output power > 6 dBm
		-20+TT	-13 dBm ≤ Output power ≤ 6 dBm
<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB} - 25</math> dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 9.</p> <p>NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For Pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD.</p> <p>NOTE 3: Image frequencies for UL CA are specified in relation to either UL or DL carrier frequency.</p> <p>NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.</p> <p>NOTE 5: The applicable frequencies for this limit are those that are enclosed in the RBs containing the DC frequency, or in</p>			

the two RBs immediately adjacent to the DC frequency but excluding any allocated RB.  
 NOTE 6:  $L_{CRB}$  is the Transmission Bandwidth for kth allocated component carrier (see Figure 5.3.1-1).  
 NOTE 7: EVM is the limit for the modulation format used in the allocated RBs.  
 NOTE 8:  $\Delta_{RB}$  is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g.  $\Delta_{RB} = 1$  or  $\Delta_{RB} = -1$  for the first adjacent RB outside of the allocated bandwidth), and may take non-integer values when the carrier spacing between the CCs is not a multiple of RB.  
 NOTE 9:  $P_{RB}$  is the transmitted power per allocated RB, measured in dBm.  
 NOTE 10: All powers are EIRP in beam peak direction.

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4A.2.3.3.5-3 for power class 3 UEs.

**Table 6.4A.2.3.3.5-3: Test Requirements for in-band emissions for power class 3**

Parameter description	Unit	Limit (NOTE 1)	Applicable Frequencies
General	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10} (\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right] + \text{TT}$	Any non-allocated RB in allocated component carrier and not allocated component carriers (NOTE 2)
IQ Image	dB	-25+TT	Image frequencies (NOTES 2, 3)
		-20+TT	
Carrier leakage	dBc	-25+TT	Carrier frequency (NOTES 4, 5)
		-20+TT	
NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of ( $P_{RB} - 25$ dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. $P_{RB}$ is defined in NOTE 9. NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For Pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD. NOTE 3: Image frequencies for UL CA are specified in relation to either UL or DL carrier frequency. NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs. NOTE 5: The applicable frequencies for this limit are those that are enclosed in the RBs containing the DC frequency, or in the two RBs immediately adjacent to the DC frequency but excluding any allocated RB. NOTE 6: $L_{CRB}$ is the Transmission Bandwidth for kth allocated component carrier (see Figure 5.3.1-1). NOTE 7: EVM is the limit for the modulation format used in the allocated RBs. NOTE 8: $\Delta_{RB}$ is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g. $\Delta_{RB} = 1$ or $\Delta_{RB} = -1$ for the first adjacent RB outside of the allocated bandwidth), and may take non-integer values when the carrier spacing between the CCs is not a multiple of RB. NOTE 9: $P_{RB}$ is the transmitted power per allocated RB, measured in dBm. NOTE 10: All powers are EIRP in beam peak direction.			

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4A.2.3.3.5-4 for power class 4 UEs.

**Table 6.4A.2.3.3.5-4: Test Requirements for in-band emissions for power class 4**

Parameter description	Unit	Limit (NOTE 1)	Applicable Frequencies
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<b>General</b>	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10} (\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right] + \text{TT}$		Any non-allocated RB in allocated component carrier and not allocated component carriers (NOTE 2)
<b>IQ Image</b>	dB	-25+TT	Output power > 21 dBm	Image frequencies (NOTES 2, 3)
		-20+TT	Output power ≤ 21 dBm	
<b>Carrier leakage</b>	dBc	-25+TT	Output power > 11 dBm	Carrier frequency (NOTES 4, 5)
		-20+TT	-13 dBm ≤ Output power ≤ 11 dBm	
<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB} - 25</math> dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 9.</p> <p>NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD.</p> <p>NOTE 3: Image frequencies for UL CA are specified in relation to either UL or DL carrier frequency.</p> <p>NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.</p> <p>NOTE 5: The applicable frequencies for this limit are those that are enclosed in the RBs containing the DC frequency, or in the two RBs immediately adjacent to the DC frequency but excluding any allocated RB.</p> <p>NOTE 6: <math>L_{CRB}</math> is the Transmission Bandwidth for kth allocated component carrier (see Figure 5.3.1-1).</p> <p>NOTE 7: EVM is the limit for the modulation format used in the allocated RBs.</p> <p>NOTE 8: <math>\Delta_{RB}</math> is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g. <math>\Delta_{RB} = 1</math> or <math>\Delta_{RB} = -1</math> for the first adjacent RB outside of the allocated bandwidth), and may take non-integer values when the carrier spacing between the CCs is not a multiple of RB.</p> <p>NOTE 9: <math>P_{RB}</math> is the transmitted power per allocated RB, measured in dBm.</p> <p>NOTE 10: All powers are EIRP in beam peak direction.</p>				

6.4A.2.3.4 In-band emissions for CA (5UL CA)

Editor’s note: This clause is incomplete. The following aspects are either missing or not yet determined:

- The test procedure is incomplete due to that power window for CA is TBD
- Measurement Uncertainty and Test Tolerance are FFS.
- Testing of the general in-band emission requirement and if yes at which UE Tx power level and with which relaxation applied to the requirement is FFS.
- TP analysis is FFS

6.4A.2.3.4.1 Test purpose

The in-band emissions are a measure of the interference falling into the non-allocated resources blocks.

The purpose of this test is to exercise the UE transmitter to verify its modulation quality in terms of in-band emissions.

6.4A.2.3.4.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 5UL CA.

6.4A.2.3.4.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.4A.2.3.0.

6.4A.2.3.4.4 Test description

Same as in clause 6.4A.2.3.1.4 with following exceptions:

- Instead of Table 6.4A.2.3.1.4.1-1 → use Table 6.4A.2.3.4.4-1.

**Table 6.4A.2.3.4.4-1: Test Configuration Table for 5UL CA**

Default Conditions					
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.			Low and High range		
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.			Lowest aggregated BW of the CA configuration Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1.			Lowest		
Test Parameters					
CA Configuration / Aggregated BW			Downlink Configuration	Uplink Configuration	
Test ID	CC & Mapping	ChBw(MHz)	RB allocation	Modulation	RB allocation (NOTE 1)
1	PCC	Default	-	DFT-s-OFDM PI/2 BPSK	Inner_Partial_Left for PC2, PC3, PC4 Inner_Partial_Left_Region2 for PC1
	SCC1			-	-
	SCC2			-	-
	SCC3			-	-
	SCC4			-	-
2	PCC			DFT-s-OFDM PI/2 BPSK	Inner_Partial_Right for PC2, PC3, PC4 Inner_Partial_Right_Region2 for PC1
	SCC1			-	-
	SCC2			-	-
	SCC3			-	-
	SCC4			-	-
3	PCC			CP-OFDM QPSK	Inner_Partial_Left for PC2, PC3, PC4 Inner_Partial_Left_Region2 for PC1
	SCC1			-	-
	SCC2			-	-
	SCC3			-	-
	SCC4			-	-
4	PCC			CP-OFDM QPSK	Inner_Partial_Right for PC2, PC3, PC4 Inner_Partial_Right_Region2 for PC1
	SCC1			-	-
	SCC2			-	-
	SCC3			-	-
	SCC4			-	-
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.					
NOTE 2: CA Configuration Test cumulative aggregated BW settings are checked separately for each CA Configuration, which applicable aggregated channel bandwidths are specified in Table 5.5A.1-1.					
NOTE 3: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".					

6.4A.2.3.4.5 Test requirement

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4A.2.3.4.5-1 for power class 1 UEs.

**Table 6.4A.2.3.4.5-1: Test Requirements for in-band emissions for power class 1**

Parameter description	Unit	Limit (NOTE 1)	Applicable Frequencies
<b>General</b>	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10} (\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right] + \text{TT}$	Any non-allocated RB in allocated component carrier and not allocated component carriers (NOTE 2)
<b>IQ Image</b>	dB	-25+TT	Output power > 27 dBm
		-20+TT	Output power ≤ 27 dBm
<b>Carrier leakage</b>	dBc	-25+TT	Output power > 17 dBm
		-20+TT	4 dBm ≤ Output power ≤ 17 dBm
<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB} - 25</math> dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 9.</p> <p>NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For Pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD.</p> <p>NOTE 3: Image frequencies for UL CA are specified in relation to either UL or DL carrier frequency.</p> <p>NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.</p> <p>NOTE 5: The applicable frequencies for this limit are those that are enclosed in the RBs containing the DC frequency, or in the two RBs immediately adjacent to the DC frequency but excluding any allocated RB.</p> <p>NOTE 6: <math>L_{CRB}</math> is the Transmission Bandwidth for kth allocated component carrier (see Figure 5.3.1-1).</p> <p>NOTE 7: EVM is the limit for the modulation format used in the allocated RBs.</p> <p>NOTE 8: <math>\Delta_{RB}</math> is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g. <math>\Delta_{RB} = 1</math> or <math>\Delta_{RB} = -1</math> for the first adjacent RB outside of the allocated bandwidth), and may take non-integer values when the carrier spacing between the CCs is not a multiple of RB.</p> <p>NOTE 9: <math>P_{RB}</math> is the transmitted power per allocated RB, measured in dBm.</p> <p>NOTE 10: All powers are EIRP in beam peak direction.</p>			

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4A.2.3.4.5-2 for power class 2 UEs.

**Table 6.4A.2.3.4.5-2: Test Requirements for in-band emissions for power class 2**

Parameter description	Unit	Limit (NOTE 1)	Applicable Frequencies
<b>General</b>	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10} (\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right] + \text{TT}$	Any non-allocated RB in allocated component carrier and not allocated component carriers (NOTE 2)
<b>IQ Image</b>	dB	-25+TT	Output power > 16 dBm
		-20+TT	Output power ≤ 16 dBm
<b>Carrier leakage</b>	dBc	-25+TT	Output power > 6 dBm
		-20+TT	-13 dBm ≤ Output power ≤ 6 dBm
<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB} - 25</math> dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 9.</p> <p>NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For Pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD.</p> <p>NOTE 3: Image frequencies for UL CA are specified in relation to either UL or DL carrier frequency.</p>			

NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.  
 NOTE 5: The applicable frequencies for this limit are those that are enclosed in the RBs containing the DC frequency, or in the two RBs immediately adjacent to the DC frequency but excluding any allocated RB.  
 NOTE 6:  $L_{CRB}$  is the Transmission Bandwidth for kth allocated component carrier (see Figure 5.3.1-1).  
 NOTE 7: EVM is the limit for the modulation format used in the allocated RBs.  
 NOTE 8:  $\Delta_{RB}$  is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g.  $\Delta_{RB} = 1$  or  $\Delta_{RB} = -1$  for the first adjacent RB outside of the allocated bandwidth), and may take non-integer values when the carrier spacing between the CCs is not a multiple of RB.  
 NOTE 9:  $P_{RB}$  is the transmitted power per allocated RB, measured in dBm.  
 NOTE 10: All powers are EIRP in beam peak direction.

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4A.2.3.4.5-3 for power class 3 UEs.

**Table 6.4A.2.3.4.5-3: Test Requirements for in-band emissions for power class 3**

Parameter description	Unit	Limit (NOTE 1)		Applicable Frequencies
General	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10}(\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right] + \text{TT}$		Any non-allocated RB in allocated component carrier and not allocated component carriers (NOTE 2)
IQ Image	dB	-25+TT	Output power > 10 dBm	Image frequencies (NOTES 2, 3)
		-20+TT	Output power ≤ 10 dBm	
Carrier leakage	dBc	-25+TT	Output power > 0 dBm	Carrier frequency (NOTES 4, 5)
		-20+TT	-13 dBm ≤ Output power ≤ 0 dBm	
<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB} - 25</math> dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 9.</p> <p>NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For Pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD.</p> <p>NOTE 3: Image frequencies for UL CA are specified in relation to either UL or DL carrier frequency.</p> <p>NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.</p> <p>NOTE 5: The applicable frequencies for this limit are those that are enclosed in the RBs containing the DC frequency, or in the two RBs immediately adjacent to the DC frequency but excluding any allocated RB.</p> <p>NOTE 6: <math>L_{CRB}</math> is the Transmission Bandwidth for kth allocated component carrier (see Figure 5.3.1-1).</p> <p>NOTE 7: EVM is the limit for the modulation format used in the allocated RBs.</p> <p>NOTE 8: <math>\Delta_{RB}</math> is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g. <math>\Delta_{RB} = 1</math> or <math>\Delta_{RB} = -1</math> for the first adjacent RB outside of the allocated bandwidth), and may take non-integer values when the carrier spacing between the CCs is not a multiple of RB.</p> <p>NOTE 9: <math>P_{RB}</math> is the transmitted power per allocated RB, measured in dBm.</p> <p>NOTE 10: All powers are EIRP in beam peak direction.</p>				

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4A.2.3.4.5-4 for power class 4 UEs.

**Table 6.4A.2.3.4.5-4: Test Requirements for in-band emissions for power class 4**

Parameter description	Unit	Limit (NOTE 1)	Applicable Frequencies
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<b>General</b>	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10} (\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right] + \text{TT}$		Any non-allocated RB in allocated component carrier and not allocated component carriers (NOTE 2)
<b>IQ Image</b>	dB	-25+TT	Output power > 21 dBm	Image frequencies (NOTES 2, 3)
		-20+TT	Output power ≤ 21 dBm	
<b>Carrier leakage</b>	dBc	-25+TT	Output power > 11 dBm	Carrier frequency (NOTES 4, 5)
		-20+TT	-13 dBm ≤ Output power ≤ 11 dBm	
<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB} - 25</math> dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 9.</p> <p>NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD.</p> <p>NOTE 3: Image frequencies for UL CA are specified in relation to either UL or DL carrier frequency.</p> <p>NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.</p> <p>NOTE 5: The applicable frequencies for this limit are those that are enclosed in the RBs containing the DC frequency, or in the two RBs immediately adjacent to the DC frequency but excluding any allocated RB.</p> <p>NOTE 6: <math>L_{CRB}</math> is the Transmission Bandwidth for kth allocated component carrier (see Figure 5.3.1-1).</p> <p>NOTE 7: EVM is the limit for the modulation format used in the allocated RBs.</p> <p>NOTE 8: <math>\Delta_{RB}</math> is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g. <math>\Delta_{RB} = 1</math> or <math>\Delta_{RB} = -1</math> for the first adjacent RB outside of the allocated bandwidth), and may take non-integer values when the carrier spacing between the CCs is not a multiple of RB.</p> <p>NOTE 9: <math>P_{RB}</math> is the transmitted power per allocated RB, measured in dBm.</p> <p>NOTE 10: All powers are EIRP in beam peak direction.</p>				

#### 6.4A.2.3.5 In-band emissions for CA (6UL CA)

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- The test procedure is incomplete due to that power window for CA is TBD
- Measurement Uncertainty and Test Tolerance are FFS.
- Testing of the general in-band emission requirement and if yes at which UE Tx power level and with which relaxation applied to the requirement is FFS.
- TP analysis is FFS

##### 6.4A.2.3.5.1 Test purpose

The in-band emissions are a measure of the interference falling into the non-allocated resources blocks.

The purpose of this test is to exercise the UE transmitter to verify its modulation quality in terms of in-band emissions.

##### 6.4A.2.3.5.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 6UL CA.

##### 6.4A.2.3.5.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.4A.2.3.0.

##### 6.4A.2.3.5.4 Test description

Same as in clause 6.4A.2.3.1.4 with following exceptions:



- Instead of Table 6.4A.2.3.1.4.1-1 → use Table 6.4A.2.3.5.4-1.

**Table 6.4A.2.3.5.4-1: Test Configuration Table for 6UL CA**

Default Conditions					
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.			Low and High range		
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.			Lowest aggregated BW of the CA configuration Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1.			Lowest		
Test Parameters					
CA Configuration / Aggregated BW			Downlink Configuration	Uplink Configuration	
Test ID	CC & Mapping	ChBw(MHz)	RB allocation	Modulation	RB allocation (NOTE 1)
1	PCC	Default	-	DFT-s-OFDM PI/2 BPSK	Inner_Partial_Left for PC2, PC3, PC4 Inner_Partial_Left_Region2 for PC1
	SCC1			-	-
	SCC2			-	-
	SCC3			-	-
	SCC4			-	-
SCC5	-			-	
2	PCC			DFT-s-OFDM PI/2 BPSK	Inner_Partial_Right for PC2, PC3, PC4 Inner_Partial_Right_Region2 for PC1
	SCC1			-	-
	SCC2			-	-
	SCC3			-	-
	SCC4			-	-
SCC5	-			-	
3	PCC			CP-OFDM QPSK	Inner_Partial_Left for PC2, PC3, PC4 Inner_Partial_Left_Region2 for PC1
	SCC1			-	-
	SCC2			-	-
	SCC3			-	-
	SCC4			-	-
SCC5	-			-	
4	PCC			CP-OFDM QPSK	Inner_Partial_Right for PC2, PC3, PC4 Inner_Partial_Right_Region2 for PC1
	SCC1			-	-
	SCC2	-	-		
	SCC3	-	-		
	SCC4	-	-		
SCC5	-	-			

NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.

NOTE 2: CA Configuration Test cumulative aggregated BW settings are checked separately for each CA Configuration, which applicable aggregated channel bandwidths are specified in Table 5.5A.1-1.

NOTE 3: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".

6.4A.2.3.5.5 Test requirement

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4A.2.3.5.5-1 for power class 1 UEs.

**Table 6.4A.2.3.5.5-1: Test Requirements for in-band emissions for power class 1**

Parameter description	Unit	Limit (NOTE 1)		Applicable Frequencies
General	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10}(\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right] + \text{TT}$		Any non-allocated RB in allocated component carrier and not allocated component carriers (NOTE 2)
IQ Image	dB	-25+TT	Output power > 27 dBm	Image frequencies (NOTES 2, 3)
		-20+TT	Output power ≤ 27 dBm	
Carrier leakage	dBc	-25+TT	Output power > 17 dBm	Carrier frequency (NOTES 4, 5)
		-20+TT	4 dBm ≤ Output power ≤ 17 dBm	
<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB}</math> - 25 dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 9.</p> <p>NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For Pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD.</p> <p>NOTE 3: Image frequencies for UL CA are specified in relation to either UL or DL carrier frequency.</p> <p>NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.</p> <p>NOTE 5: The applicable frequencies for this limit are those that are enclosed in the RBs containing the DC frequency, or in the two RBs immediately adjacent to the DC frequency but excluding any allocated RB.</p> <p>NOTE 6: <math>L_{CRB}</math> is the Transmission Bandwidth for kth allocated component carrier (see Figure 5.3.1-1).</p> <p>NOTE 7: EVM is the limit for the modulation format used in the allocated RBs.</p> <p>NOTE 8: <math>\Delta_{RB}</math> is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g. <math>\Delta_{RB} = 1</math> or <math>\Delta_{RB} = -1</math> for the first adjacent RB outside of the allocated bandwidth), and may take non-integer values when the carrier spacing between the CCs is not a multiple of RB.</p> <p>NOTE 9: <math>P_{RB}</math> is the transmitted power per allocated RB, measured in dBm.</p> <p>NOTE 10: All powers are EIRP in beam peak direction.</p>				

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4A.2.3.5.5-2 for power class 2 UEs.

**Table 6.4A.2.3.5.5-2: Test Requirements for in-band emissions for power class 2**

Parameter description	Unit	Limit (NOTE 1)		Applicable Frequencies
General	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10}(\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right] + \text{TT}$		Any non-allocated RB in allocated component carrier and not allocated component carriers (NOTE 2)
IQ Image	dB	-25+TT	Output power > 16 dBm	Image frequencies (NOTES 2, 3)
		-20+TT	Output power ≤ 16 dBm	
Carrier leakage	dBc	-25+TT	Output power > 6 dBm	Carrier frequency (NOTES 4, 5)
		-20+TT	-13 dBm ≤ Output power ≤ 6 dBm	
<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB}</math> - 25 dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 9.</p>				

- NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For Pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD.
- NOTE 3: Image frequencies for UL CA are specified in relation to either UL or DL carrier frequency.
- NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.
- NOTE 5: The applicable frequencies for this limit are those that are enclosed in the RBs containing the DC frequency, or in the two RBs immediately adjacent to the DC frequency but excluding any allocated RB.
- NOTE 6:  $L_{CRB}$  is the Transmission Bandwidth for kth allocated component carrier (see Figure 5.3.1-1).
- NOTE 7: EVM is the limit for the modulation format used in the allocated RBs.
- NOTE 8:  $\Delta_{RB}$  is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g.  $\Delta_{RB} = 1$  or  $\Delta_{RB} = -1$  for the first adjacent RB outside of the allocated bandwidth), and may take non-integer values when the carrier spacing between the CCs is not a multiple of RB.
- NOTE 9:  $P_{RB}$  is the transmitted power per allocated RB, measured in dBm.
- NOTE 10: All powers are EIRP in beam peak direction.

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4A.2.3.5.5-3 for power class 3 UEs.

**Table 6.4A.2.3.5.5-3: Test Requirements for in-band emissions for power class 3**

Parameter description	Unit	Limit (NOTE 1)	Applicable Frequencies
General	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10} (\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right] + \text{TT}$	Any non-allocated RB in allocated component carrier and not allocated component carriers (NOTE 2)
IQ Image	dB	-25+TT	Image frequencies (NOTES 2, 3)
		-20+TT	
Carrier leakage	dBc	-25+TT	Carrier frequency (NOTES 4, 5)
		-20+TT	

NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of ( $P_{RB} - 25$  dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply.  $P_{RB}$  is defined in NOTE 9.

NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For Pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD.

NOTE 3: Image frequencies for UL CA are specified in relation to either UL or DL carrier frequency.

NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.

NOTE 5: The applicable frequencies for this limit are those that are enclosed in the RBs containing the DC frequency, or in the two RBs immediately adjacent to the DC frequency but excluding any allocated RB.

NOTE 6:  $L_{CRB}$  is the Transmission Bandwidth for kth allocated component carrier (see Figure 5.3.1-1).

NOTE 7: EVM is the limit for the modulation format used in the allocated RBs.

NOTE 8:  $\Delta_{RB}$  is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g.  $\Delta_{RB} = 1$  or  $\Delta_{RB} = -1$  for the first adjacent RB outside of the allocated bandwidth), and may take non-integer values when the carrier spacing between the CCs is not a multiple of RB.

NOTE 9:  $P_{RB}$  is the transmitted power per allocated RB, measured in dBm.

NOTE 10: All powers are EIRP in beam peak direction.

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4A.2.3.5.5-4 for power class 4 UEs.

**Table 6.4A.2.3.5.5-4: Test Requirements for in-band emissions for power class 4**

Parameter	Unit	Limit (NOTE 1)	Applicable
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description			Frequencies
General	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10} (\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right] + \text{TT}$	Any non-allocated RB in allocated component carrier and not allocated component carriers (NOTE 2)
IQ Image	dB	-25+TT	Output power > 21 dBm
		-20+TT	Output power ≤ 21 dBm
Carrier leakage	dBc	-25+TT	Output power > 11 dBm
		-20+TT	-13 dBm ≤ Output power ≤ 11 dBm
<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB} - 25</math> dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 9.</p> <p>NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD.</p> <p>NOTE 3: Image frequencies for UL CA are specified in relation to either UL or DL carrier frequency.</p> <p>NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.</p> <p>NOTE 5: The applicable frequencies for this limit are those that are enclosed in the RBs containing the DC frequency, or in the two RBs immediately adjacent to the DC frequency but excluding any allocated RB.</p> <p>NOTE 6: <math>L_{CRB}</math> is the Transmission Bandwidth for kth allocated component carrier (see Figure 5.3.1-1).</p> <p>NOTE 7: EVM is the limit for the modulation format used in the allocated RBs.</p> <p>NOTE 8: <math>\Delta_{RB}</math> is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g. <math>\Delta_{RB} = 1</math> or <math>\Delta_{RB} = -1</math> for the first adjacent RB outside of the allocated bandwidth), and may take non-integer values when the carrier spacing between the CCs is not a multiple of RB.</p> <p>NOTE 9: <math>P_{RB}</math> is the transmitted power per allocated RB, measured in dBm.</p> <p>NOTE 10: All powers are EIRP in beam peak direction.</p>			

6.4A.2.3.6 In-band emissions for CA (7UL CA)

Editor’s note: This clause is incomplete. The following aspects are either missing or not yet determined:

- The test procedure is incomplete due to that power window for CA is TBD
- Measurement Uncertainty and Test Tolerance are FFS.
- Testing of the general in-band emission requirement and if yes at which UE Tx power level and with which relaxation applied to the requirement is FFS.
- TP analysis is FFS

6.4A.2.3.6.1 Test purpose

The in-band emissions are a measure of the interference falling into the non-allocated resources blocks.

The purpose of this test is to exercise the UE transmitter to verify its modulation quality in terms of in-band emissions.

6.4A.2.3.6.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 7UL CA.

6.4A.2.3.6.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.4A.2.3.0.

6.4A.2.3.6.4 Test description

Same as in clause 6.4A.2.3.1.4 with following exceptions:

- Instead of Table 6.4A.2.3.1.4.1-1 → use Table 6.4A.2.3.6.4-1.

**Table 6.4A.2.3.6.4-1: Test Configuration Table for 7UL CA**

Default Conditions					
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.			Low and High range		
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.			Lowest aggregated BW of the CA configuration Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1.			Lowest		
Test Parameters					
CA Configuration / Aggregated BW			Downlink Configuration	Uplink Configuration	
Test ID	CC & Mapping	ChBw(MHz)	RB allocation	Modulation	RB allocation (NOTE 1)
1	PCC	Default	-	DFT-s-OFDM PI/2 BPSK	Inner_Partial_Left for PC2, PC3, PC4 Inner_Partial_Left_Region2 for PC1
	SCC1			-	-
	SCC2			-	-
	SCC3			-	-
	SCC4			-	-
	SCC5			-	-
2	PCC			DFT-s-OFDM PI/2 BPSK	Inner_Partial_Right for PC2, PC3, PC4 Inner_Partial_Right_Region2 for PC1
	SCC1			-	-
	SCC2			-	-
	SCC3			-	-
	SCC4			-	-
	SCC5			-	-
3	PCC			CP-OFDM QPSK	Inner_Partial_Left for PC2, PC3, PC4 Inner_Partial_Left_Region2 for PC1
	SCC1			-	-
	SCC2			-	-
	SCC3			-	-
	SCC4			-	-
	SCC5			-	-
4	PCC			CP-OFDM QPSK	Inner_Partial_Right for PC2, PC3, PC4 Inner_Partial_Right_Region2 for PC1
	SCC1			-	-
	SCC2			-	-
	SCC3			-	-
	SCC4			-	-
	SCC5			-	-

NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.

NOTE 2: CA Configuration Test cumulative aggregated BW settings are checked separately for each CA Configuration, which applicable aggregated channel bandwidths are specified in Table 5.5A.1-1.  
 NOTE 3: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".

6.4A.2.3.6.5 Test requirement

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4A.2.3.6.5-1 for power class 1 UEs.

**Table 6.4A.2.3.6.5-1: Test Requirements for in-band emissions for power class 1**

Parameter description	Unit	Limit (NOTE 1)	Applicable Frequencies
General	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10} (\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right] + \text{TT}$	Any non-allocated RB in allocated component carrier and not allocated component carriers (NOTE 2)
IQ Image	dB	-25+TT	Image frequencies (NOTES 2, 3)
		Output power > 27 dBm	
Carrier leakage	dBc	-20+TT	Carrier frequency (NOTES 4, 5)
		Output power ≤ 27 dBm	
Carrier leakage	dBc	-25+TT	Carrier frequency (NOTES 4, 5)
		4 dBm ≤ Output power ≤ 17 dBm	

NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of ( $P_{RB} - 25$  dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply.  $P_{RB}$  is defined in NOTE 9.

NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For Pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD.

NOTE 3: Image frequencies for UL CA are specified in relation to either UL or DL carrier frequency.

NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.

NOTE 5: The applicable frequencies for this limit are those that are enclosed in the RBs containing the DC frequency, or in the two RBs immediately adjacent to the DC frequency but excluding any allocated RB.

NOTE 6:  $L_{CRB}$  is the Transmission Bandwidth for kth allocated component carrier (see Figure 5.3.1-1).

NOTE 7: EVM is the limit for the modulation format used in the allocated RBs.

NOTE 8:  $\Delta_{RB}$  is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g.  $\Delta_{RB} = 1$  or  $\Delta_{RB} = -1$  for the first adjacent RB outside of the allocated bandwidth), and may take non-integer values when the carrier spacing between the CCs is not a multiple of RB.

NOTE 9:  $P_{RB}$  is the transmitted power per allocated RB, measured in dBm.

NOTE 10: All powers are EIRP in beam peak direction.

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4A.2.3.6.5-2 for power class 2 UEs.

**Table 6.4A.2.3.6.5-2: Test Requirements for in-band emissions for power class 2**

Parameter description	Unit	Limit (NOTE 1)	Applicable Frequencies
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<b>General</b>	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10}(\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right] + \text{TT}$		Any non-allocated RB in allocated component carrier and not allocated component carriers (NOTE 2)
<b>IQ Image</b>	dB	-25+TT	Output power > 16 dBm	Image frequencies (NOTES 2, 3)
		-20+TT	Output power ≤ 16 dBm	
<b>Carrier leakage</b>	dBc	-25+TT	Output power > 6 dBm	Carrier frequency (NOTES 4, 5)
		-20+TT	-13 dBm ≤ Output power ≤ 6 dBm	
<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB} - 25</math> dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 9.</p> <p>NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For Pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD.</p> <p>NOTE 3: Image frequencies for UL CA are specified in relation to either UL or DL carrier frequency.</p> <p>NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.</p> <p>NOTE 5: The applicable frequencies for this limit are those that are enclosed in the RBs containing the DC frequency, or in the two RBs immediately adjacent to the DC frequency but excluding any allocated RB.</p> <p>NOTE 6: <math>L_{CRB}</math> is the Transmission Bandwidth for kth allocated component carrier (see Figure 5.3.1-1).</p> <p>NOTE 7: EVM is the limit for the modulation format used in the allocated RBs.</p> <p>NOTE 8: <math>\Delta_{RB}</math> is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g. <math>\Delta_{RB} = 1</math> or <math>\Delta_{RB} = -1</math> for the first adjacent RB outside of the allocated bandwidth), and may take non-integer values when the carrier spacing between the CCs is not a multiple of RB.</p> <p>NOTE 9: <math>P_{RB}</math> is the transmitted power per allocated RB, measured in dBm.</p> <p>NOTE 10: All powers are EIRP in beam peak direction.</p>				

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4A.2.3.6.5-3 for power class 3 UEs.

**Table 6.4A.2.3.6.5-3: Test Requirements for in-band emissions for power class 3**

Parameter description	Unit	Limit (NOTE 1)		Applicable Frequencies
<b>General</b>	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10}(\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right] + \text{TT}$		Any non-allocated RB in allocated component carrier and not allocated component carriers (NOTE 2)
<b>IQ Image</b>	dB	-25+TT	Output power > 10 dBm	Image frequencies (NOTES 2, 3)
		-20+TT	Output power ≤ 10 dBm	
<b>Carrier leakage</b>	dBc	-25+TT	Output power > 0 dBm	Carrier frequency (NOTES 4, 5)
		-20+TT	-13 dBm ≤ Output power ≤ 0 dBm	
<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB} - 25</math> dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 9.</p> <p>NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For Pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD.</p> <p>NOTE 3: Image frequencies for UL CA are specified in relation to either UL or DL carrier frequency.</p> <p>NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.</p> <p>NOTE 5: The applicable frequencies for this limit are those that are enclosed in the RBs containing the DC frequency, or in</p>				

the two RBs immediately adjacent to the DC frequency but excluding any allocated RB.  
 NOTE 6:  $L_{CRB}$  is the Transmission Bandwidth for kth allocated component carrier (see Figure 5.3.1-1).  
 NOTE 7: EVM is the limit for the modulation format used in the allocated RBs.  
 NOTE 8:  $\Delta_{RB}$  is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g.  $\Delta_{RB} = 1$  or  $\Delta_{RB} = -1$  for the first adjacent RB outside of the allocated bandwidth), and may take non-integer values when the carrier spacing between the CCs is not a multiple of RB.  
 NOTE 9:  $P_{RB}$  is the transmitted power per allocated RB, measured in dBm.  
 NOTE 10: All powers are EIRP in beam peak direction.

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4A.2.3.6.5-4 for power class 4 UEs.

**Table 6.4A.2.3.6.5-4: Test Requirements for in-band emissions for power class 4**

Parameter description	Unit	Limit (NOTE 1)		Applicable Frequencies
General	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10} (\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right] + \text{TT}$		Any non-allocated RB in allocated component carrier and not allocated component carriers (NOTE 2)
IQ Image	dB	-25+TT	Output power > 21 dBm	Image frequencies (NOTES 2, 3)
		-20+TT	Output power ≤ 21 dBm	
Carrier leakage	dBc	-25+TT	Output power > 11 dBm	Carrier frequency (NOTES 4, 5)
		-20+TT	-13 dBm ≤ Output power ≤ 11 dBm	
NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of ( $P_{RB} - 25$ dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. $P_{RB}$ is defined in NOTE 9. NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD. NOTE 3: Image frequencies for UL CA are specified in relation to either UL or DL carrier frequency. NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs. NOTE 5: The applicable frequencies for this limit are those that are enclosed in the RBs containing the DC frequency, or in the two RBs immediately adjacent to the DC frequency but excluding any allocated RB. NOTE 6: $L_{CRB}$ is the Transmission Bandwidth for kth allocated component carrier (see Figure 5.3.1-1). NOTE 7: EVM is the limit for the modulation format used in the allocated RBs. NOTE 8: $\Delta_{RB}$ is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g. $\Delta_{RB} = 1$ or $\Delta_{RB} = -1$ for the first adjacent RB outside of the allocated bandwidth), and may take non-integer values when the carrier spacing between the CCs is not a multiple of RB. NOTE 9: $P_{RB}$ is the transmitted power per allocated RB, measured in dBm. NOTE 10: All powers are EIRP in beam peak direction.				

6.4A.2.3.7 In-band emissions for CA (8UL CA)

Editor’s note: This clause is incomplete. The following aspects are either missing or not yet determined:

- The test procedure is incomplete due to that power window for CA is TBD
- Measurement Uncertainty and Test Tolerance are FFS.
- Testing of the general in-band emission requirement and if yes at which UE Tx power level and with which relaxation applied to the requirement is FFS.
- TP analysis is FFS



6.4A.2.3.7.1 Test purpose

The in-band emissions are a measure of the interference falling into the non-allocated resources blocks.

The purpose of this test is to exercise the UE transmitter to verify its modulation quality in terms of in-band emissions.

6.4A.2.3.7.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 8UL CA.

6.4A.2.3.7.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.4A.2.3.0.

6.4A.2.3.7.4 Test description

Same as in clause 6.4A.2.3.1.4 with following exceptions:

- Instead of Table 6.4A.2.3.1.4.1-1 → use Table 6.4A.2.3.7.4-1.

**Table 6.4A.2.3.7.4-1: Test Configuration Table for 8UL CA**

Default Conditions					
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.			Low and High range		
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.			Lowest aggregated BW of the CA configuration Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1.			Lowest		
Test Parameters					
CA Configuration / Aggregated BW			Downlink Configuration	Uplink Configuration	
Test ID	CC & Mapping	ChBw(MHz)	RB allocation	Modulation	RB allocation (NOTE 1)
1	PCC	Default	-	DFT-s-OFDM PI/2 BPSK	Inner_Partial_Left for PC2, PC3, PC4 Inner_Partial_Left_Region2 for PC1
	SCC1			-	-
	SCC2			-	-
	SCC3			-	-
	SCC4			-	-
	SCC5			-	-
	SCC6			-	-
	SCC7			-	-
2	PCC	Default	-	DFT-s-OFDM PI/2 BPSK	Inner_Partial_Right for PC2, PC3, PC4 Inner_Partial_Right_Region2 for PC1
	SCC1			-	-
	SCC2			-	-
	SCC3			-	-
	SCC4			-	-
	SCC5			-	-
	SCC6			-	-
	SCC7			-	-
3	PCC	Default	-	CP-OFDM QPSK	Inner_Partial_Left for PC2, PC3, PC4 Inner_Partial_Left_Region2 for PC1
	SCC1			-	-

	SCC2			-	-	
	SCC3			-	-	
	SCC4			-	-	
	SCC5			-	-	
	SCC6			-	-	
	SCC7			-	-	
	4	PCC			CP-OFDM QPSK	Inner_Partial_Right for PC2, PC3, PC4 Inner_Partial_Right_Region2 for PC1
		SCC1			-	-
SCC2				-	-	
SCC3				-	-	
SCC4				-	-	
SCC5				-	-	
SCC6				-	-	
SCC7				-	-	

NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.

NOTE 2: CA Configuration Test cumulative aggregated BW settings are checked separately for each CA Configuration, which applicable aggregated channel bandwidths are specified in Table 5.5A.1-1.

NOTE 3: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".

6.4A.2.3.7.5 Test requirement

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4A.2.3.7.5-1 for power class 1 UEs.

**Table 6.4A.2.3.7.5-1: Test Requirements for in-band emissions for power class 1**

Parameter description	Unit	Limit (NOTE 1)		Applicable Frequencies
General	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10}(\text{EVM}) - 5 \cdot \frac{(\Delta_{RB} - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right] + \text{TT}$		Any non-allocated RB in allocated component carrier and not allocated component carriers (NOTE 2)
IQ Image	dB	-25+TT	Output power > 27 dBm	Image frequencies (NOTES 2, 3)
		-20+TT	Output power ≤ 27 dBm	
Carrier leakage	dBc	-25+TT	Output power > 17 dBm	Carrier frequency (NOTES 4, 5)
		-20+TT	4 dBm ≤ Output power ≤ 17 dBm	

NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of ( $P_{RB} - 25$  dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply.  $P_{RB}$  is defined in NOTE 9.

NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For Pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD.

NOTE 3: Image frequencies for UL CA are specified in relation to either UL or DL carrier frequency.

NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.

NOTE 5: The applicable frequencies for this limit are those that are enclosed in the RBs containing the DC frequency, or in the two RBs immediately adjacent to the DC frequency but excluding any allocated RB.

NOTE 6:  $L_{CRB}$  is the Transmission Bandwidth for kth allocated component carrier (see Figure 5.3.1-1).

NOTE 7: EVM is the limit for the modulation format used in the allocated RBs.

NOTE 8:  $\Delta_{RB}$  is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g.  $\Delta_{RB} = 1$  or

$\Delta_{RB} = -1$  for the first adjacent RB outside of the allocated bandwidth), and may take non-integer values when the carrier spacing between the CCs is not a multiple of RB.  
 NOTE 9:  $P_{RB}$  is the transmitted power per allocated RB, measured in dBm.  
 NOTE 10: All powers are EIRP in beam peak direction.

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4A.2.3.7.5-2 for power class 2 UEs.

**Table 6.4A.2.3.7.5-2: Test Requirements for in-band emissions for power class 2**

Parameter description	Unit	Limit (NOTE 1)		Applicable Frequencies
General	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10}(\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right] + \text{TT}$		Any non-allocated RB in allocated component carrier and not allocated component carriers (NOTE 2)
IQ Image	dB	-20+TT	Output power ≤ 16 dBm	Carrier frequency (NOTES 4, 5)
		-25+TT	Output power > 6 dBm	
Carrier leakage	dBc	-20+TT	-13 dBm ≤ Output power ≤ 6 dBm	
		<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB} - 25</math> dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 9.</p> <p>NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For Pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD.</p> <p>NOTE 3: Image frequencies for UL CA are specified in relation to either UL or DL carrier frequency.</p> <p>NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.</p> <p>NOTE 5: The applicable frequencies for this limit are those that are enclosed in the RBs containing the DC frequency, or in the two RBs immediately adjacent to the DC frequency but excluding any allocated RB.</p> <p>NOTE 6: <math>L_{CRB}</math> is the Transmission Bandwidth for kth allocated component carrier (see Figure 5.3.1-1).</p> <p>NOTE 7: EVM is the limit for the modulation format used in the allocated RBs.</p> <p>NOTE 8: <math>\Delta_{RB}</math> is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g. <math>\Delta_{RB} = 1</math> or <math>\Delta_{RB} = -1</math> for the first adjacent RB outside of the allocated bandwidth), and may take non-integer values when the carrier spacing between the CCs is not a multiple of RB.</p> <p>NOTE 9: <math>P_{RB}</math> is the transmitted power per allocated RB, measured in dBm.</p> <p>NOTE 10: All powers are EIRP in beam peak direction.</p>		

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4A.2.3.7.5-3 for power class 3 UEs.

**Table 6.4A.2.3.7.5-3: Test Requirements for in-band emissions for power class 3**

Parameter description	Unit	Limit (NOTE 1)		Applicable Frequencies
General	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10}(\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right] + \text{TT}$		Any non-allocated RB in allocated component carrier and not allocated component carriers (NOTE 2)
IQ Image	dB	-20+TT	Output power ≤ 10 dBm	

Carrier leakage	dBc	-25+TT	Output power > 0 dBm	Carrier frequency (NOTES 4, 5)
		-20+TT	-13 dBm ≤ Output power ≤ 0 dBm	
NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of ( $P_{RB} - 25$ dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. $P_{RB}$ is defined in NOTE 9.				
NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD.				
NOTE 3: Image frequencies for UL CA are specified in relation to either UL or DL carrier frequency.				
NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.				
NOTE 5: The applicable frequencies for this limit are those that are enclosed in the RBs containing the DC frequency, or in the two RBs immediately adjacent to the DC frequency but excluding any allocated RB.				
NOTE 6: $L_{CRB}$ is the Transmission Bandwidth for kth allocated component carrier (see Figure 5.3.1-1).				
NOTE 7: EVM is the limit for the modulation format used in the allocated RBs.				
NOTE 8: $\Delta_{RB}$ is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g. $\Delta_{RB} = 1$ or $\Delta_{RB} = -1$ for the first adjacent RB outside of the allocated bandwidth), and may take non-integer values when the carrier spacing between the CCs is not a multiple of RB.				
NOTE 9: $P_{RB}$ is the transmitted power per allocated RB, measured in dBm.				
NOTE 10: All powers are EIRP in beam peak direction.				

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage Table 6.4A.2.3.7.5-4 for power class 4 UEs.

**Table 6.4A.2.3.7.5-4: Test Requirements for in-band emissions for power class 4**

Parameter description	Unit	Limit (NOTE 1)		Applicable Frequencies
General	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10}(\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right] + \text{TT}$		Any non-allocated RB in allocated component carrier and not allocated component carriers (NOTE 2)
IQ Image	dB	-25+TT	Output power > 21 dBm	Image frequencies (NOTES 2, 3)
		-20+TT	Output power ≤ 21 dBm	
Carrier leakage	dBc	-25+TT	Output power > 11 dBm	Carrier frequency (NOTES 4, 5)
		-20+TT	-13 dBm ≤ Output power ≤ 11 dBm	
NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of ( $P_{RB} - 25$ dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. $P_{RB}$ is defined in NOTE 9.				
NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD.				
NOTE 3: Image frequencies for UL CA are specified in relation to either UL or DL carrier frequency.				
NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.				
NOTE 5: The applicable frequencies for this limit are those that are enclosed in the RBs containing the DC frequency, or in the two RBs immediately adjacent to the DC frequency but excluding any allocated RB.				
NOTE 6: $L_{CRB}$ is the Transmission Bandwidth for kth allocated component carrier (see Figure 5.3.1-1).				
NOTE 7: EVM is the limit for the modulation format used in the allocated RBs.				
NOTE 8: $\Delta_{RB}$ is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g. $\Delta_{RB} = 1$ or $\Delta_{RB} = -1$ for the first adjacent RB outside of the allocated bandwidth), and may take non-integer values when the carrier spacing between the CCs is not a multiple of RB.				
NOTE 9: $P_{RB}$ is the transmitted power per allocated RB, measured in dBm.				
NOTE 10: All powers are EIRP in beam peak direction.				

6.4A.2.4 Void

6.4A.2.5 Void

## 6.4D Transmit signal quality for UL MIMO

### 6.4D.0 General

For a UE supporting UL MIMO, the transmit modulation quality requirements in clause 6.4 apply but with all references to sub-clauses 6.3.1.3.x in clause 6.4 redirected to sub-clauses 6.3D.1.3.x, where 'x' depends on power class. The requirements apply when the UE is configured for 2-layer UL MIMO transmission as specified in Table 6.2D.1.0-1.

The requirement may alternatively be verified in each of the single layer UL MIMO configurations as specified in Table 6.4D.0-1. In this case, the transmit modulation quality requirements in clause 6.4 apply without modification.

**Table 6.4D.0-1: Alternative UL MIMO configuration for transmit signal quality tests**

Transmission scheme	DCI format	TPMI Index
Codebook based uplink	DCI format 0_1	0
Codebook based uplink	DCI format 0_1	1

### 6.4D.1 Frequency error for UL MIMO

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- OTA test procedure for UL MIMO is still under investigation.
- Test config table is still FFS.
- TP analysis is FFS.
- Measurement Uncertainty and Test Tolerances are FFS.

#### 6.4D.1.1 Test purpose

This test verifies the ability of both, the receiver and the transmitter, to process frequency correctly.

Receiver: to extract the correct frequency from the stimulus signal, offered by the System simulator, under ideal propagation conditions and low level.

Transmitter: to derive the correct modulated carrier frequency for each layer from the results, gained by the receiver.

#### 6.4D.1.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that support UL MIMO.

#### 6.4D.1.3 Minimum conformance requirements

For a UE supporting UL MIMO, the UE basic measurement interval of modulated carrier frequency is 1 UL slot. The mean value of basic measurements of UE modulated carrier frequency at each layer shall be accurate to within  $\pm 0.1$  PPM observed over a period of 1 msec of cumulated measurement intervals compared to the carrier frequency received from the NR gNB.

The normative reference for this requirement is TS 38.101-2 [3] clause 6.4D.1

## 6.4D.1.4 Test description

## 6.4D.1.4.1 Initial condition

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, test channel bandwidths and sub-carrier spacing based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each combination of channel bandwidth and sub-carrier spacing, are shown in Table 6.4D.1.4.1-1. The details of the uplink and downlink reference measurement channels (RMCs) are specified in Annexes A.2 and A.3. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.4D.1.4.1-1: Test Configuration Table**

Initial Conditions				
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal, TL, TH	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1			FFS	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1			FFS	
Test SCS as specified in Table 5.3.5-1.			FFS	
Test Parameters				
Test ID	Downlink Configuration		Uplink Configuration	
	Modulation	RB allocation	Modulation	RB allocation
1	FFS	FFS	FFS	FFS

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and section A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The DL and UL Reference Measurement channels are set according to Table 6.4D.1.4.1-1.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.4D.1.4.3

## 6.4D.1.4.2 Test procedure

1. Retrieve the LO position from the parameter txDirectCurrentLocation in UplinkTxDirectCurrent IE.
2. SS transmits PDSCH via PDCCH DCI format 1\_1 for C\_RNTI to transmit the DL RMC according to Table 6.4D.1.4.1-1. The SS sends downlink MAC padding bits on the DL RMC.
3. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.4D.1.4.1-1. Since the UL has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC. The PDCCH DCI format 0\_1 is specified with the condition 2Tx\_UL\_MIMO in 38.508-1[10] subclause 4.3.6.1.1.2.
5. Set the UE in the Inband Tx beam peak direction and apply the associated polarization for the DL, both found with a 3D EIRP scan as performed in Annex K.1.1. Connect the SS (System Simulator) with the DUT through the measurement antenna with polarization reference PolLink to form the TX beam towards the TX beam peak direction and respective polarization. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.

4. Send continuously uplink power control "up" commands to the UE in every uplink scheduling information to the UE so that the UE transmits at  $P_{UMAX}$  level for the duration of the test. Allow at least 200ms starting from the first TPC Command for the UE to reach  $P_{UMAX}$  level. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
6. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition TxRx.
7. Measure the Frequency Error using Global In-Channel Tx-Test (Annex E) at each layer for the  $\theta$ - and  $\phi$ -polarization of the UL. For TDD, only slots consisting of only UL symbols are under test.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

#### 6.4D.1.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 ensuring Table 4.6.3-182 with condition 2TX\_UL\_MIMO.

#### 6.4D.1.5 Test requirement

The 10 frequency error  $\Delta f$  results for the  $\theta$ -polarization or the 10 frequency error  $\Delta f$  results for the  $\phi$ -polarization must fulfil the test requirement:

$$|\Delta f| \leq (0.1 \text{ PPM} + 0.005 \text{ PPM})$$

### 6.4D.2 Transmit signal quality for UL MIMO

Transmit modulation quality defines the modulation quality for expected in-channel RF transmissions from the UE. The transmit modulation quality is specified in terms of:

- Error Vector Magnitude (EVM) for the allocated resource blocks (RBs)
- EVM equalizer spectrum flatness derived from the equalizer coefficients generated by the EVM measurement process
- Carrier leakage
- In-band emissions for the non-allocated RB

#### 6.4D.2.1 Error vector magnitude for UL MIMO

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- OTA test procedure for UL MIMO is still under investigation.
- Test config table is FFS.
- TP analysis is FFS.
- Measurement Uncertainty and Test Tolerances are FFS.

##### 6.4D.2.1.1 Test purpose

The Error Vector Magnitude is a measure of the difference between the reference waveform and the measured waveform. This difference is called the error vector.

##### 6.4D.2.1.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that support UL MIMO.

## 6.4D.2.1.3 Minimum conformance requirements

For a UE supporting UL MIMO, the RMS average of the basic EVM measurements for the average EVM case, and for the reference signal EVM case, for the different modulation schemes shall not exceed the values specified in Table 6.4D.2.1.3-1 for the parameters defined in Table 6.4D.2.1.3-2 or Table 6.4D.2.1.3-3 depending on UE power class. For EVM evaluation purposes, all 13 PRACH preamble formats and all 5 PUCCH formats are considered to have the same EVM requirement as QPSK modulated.

The measurement interval for the EVM determination is 10 subframes. The requirement is verified with the test metric of EVM (Link=TX beam peak direction, Meas=Link angle).

**Table 6.4D.2.1.3-1: Minimum requirements for error vector magnitude**

Parameter	Unit	Average EVM level	Reference signal EVM level
Pi/2 BPSK	%	30.0	30.0
QPSK	%	17.5	17.5
16 QAM	%	12.5	12.5
64 QAM	%	8.0	8.0

**Table 6.4D.2.1.3-2: Parameters for Error Vector Magnitude for power class 1**

Parameter	Unit	Level
UE EIRP	dBm	≥ 4
UE EIRP for UL 16QAM	dBm	≥ 7
UE EIRP for UL 64QAM	dBm	≥ 11
Operating conditions		Normal conditions

**Table 6.4D.2.1.3-3: Parameters for Error Vector Magnitude for power class 2, 3, and 4**

Parameter	Unit	Level
UE EIRP	dBm	≥ -13
UE EIRP for UL 16QAM	dBm	≥ -10
UE EIRP for UL 64QAM	dBm	≥ -6
Operating conditions		Normal conditions

The normative reference for this requirement is TS 38.101-2 [3] clause 6.4D.2.

## 6.4D.2.1.4 Test description 6.4D.2.1.4.1 Initial condition

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, test channel bandwidths and sub-carrier spacing based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each combination of channel bandwidth and sub-carrier spacing, are shown in Tables 6.4D.2.1.4.1-1, 6.4D.2.1.4.1-1 and 6.4D.2.1.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annex A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.4D.2.1.4.1-1: Test Configuration Table for PUSCH**

Initial Conditions		
Test Environment as specified in TS 38.508-1 [10] subclause 4.1	FFS	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1	FFS	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1	FFS	
Test SCS as specified in Table 5.3.5-1	FFS	
Test Parameters		
Test ID	Downlink Configuration	Uplink Configuration



	-	<b>Modulation</b>	<b>RB allocation (NOTE 1)</b>
1		FFS	FFS
2			
3			
4			
5			
6			
7			
8			
9			
10			
11			
12			
13			
14			
NOTE 1:			
NOTE 2:			

**Table 6.4D.2.1.4.1-2: Test Configuration Table for PUCCH**

<b>Initial Conditions</b>				
Test Environment as specified in TS 38.508-1 [10] subclause 4.1		FFS		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1		FFS / See Table 6.4D.2.1.4.1-1		
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1		FFS / See Table 6.4D.2.1.4.1-1		
Test SCS as specified in Table 5.3.5-1		FFS / See Table 6.4D.2.1.4.1-1		
<b>Test Parameters</b>				
<b>ID</b>	<b>Downlink Configuration</b>		<b>Uplink Configuration</b>	
	Modulation	RB allocation	Waveform	PUCCH format
1	FFS			
2	FFS			
NOTE 1:				
NOTE 2:				

**Table 6.4D.2.1.4.1-3: Test Configuration for PRACH**

<b>Initial Conditions</b>	
Test Environment as specified in TS 38.508-1 [10] subclause 4.1	FFS
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1	FFS / See Table 6.4.2.1.4.1-1
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1	FFS / See Table 6.4.2.1.4.1-1
Test SCS as specified in Table 5.3.5-1	FFS / See Table 6.4.2.1.4.1-1
<b>PRACH preamble format</b>	
PRACH Configuration Index	FFS
SS/PBCH SSS EPRE setting (dBm/120kHz)	FFS

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, in Figure A.3.3.1.1 for TE diagram and section A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.

4. The UL Reference Measurement channels are set according to Tables 6.4D.2.1.4.1-1, 6.4D.2.1.4.1-1 and 6.4D.2.1.4.1-3.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.4D.2.1.4.3

#### 6.4D.2.1.4.2 Test procedure

Test procedure for PUSCH:

- 1.1 Retrieve the LO position from the parameter txDirectCurrentLocation in UplinkTxDirectCurrent IE.
  - 1.2 SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.4D.2.1.4.1-1. Since the UE has no payload data to send, the UE transmits uplink MAC padding bits on the UL RMC.
  - 1.3 Set the UE in the Inband Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 2) for the UE Tx beam selection to complete.
  - 1.4 Send continuously uplink power control "up" commands in the uplink scheduling information to the UE until the UE transmits at P<sub>UMAX</sub> level. Allow at least 200 ms starting from the first TPC command in this step for the UE to reach P<sub>UMAX</sub> level. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 2) for the UE Tx beam selection to complete.
  - 1.5 SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition TxRx.
  - 1.6 Measure the EVM<sub>θ</sub>, EVM<sub>φ</sub>,  $\overline{EVM}_{\text{DMRS},\theta}$  and  $\overline{EVM}_{\text{DMRS},\phi}$  using Global In-Channel Tx-Test (Annex E) for the θ- and φ-polarizations, respectively. For TDD, only slots consisting of only UL symbols are under test. Calculate  $\overline{EVM}_{\text{DMRS}} = \min(\overline{EVM}_{\text{DMRS},\theta}, \overline{EVM}_{\text{DMRS},\phi})$  and  $EVM = \min(EVM_{\theta}, EVM_{\phi})$ .
  - 1.7 SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.
- NOTE1: When switching to DFT-s-OFDM waveform, as specified in Table 6.4D.2.1.4.1-1, send an NR RRCReconfiguration message according to TS 38.508-1 [10] clause 4.6.3 Table 4.6.3-118 PUSCH-Config with TRANSFORM\_PRECODER\_ENABLED condition.
- NOTE 2: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

Test procedure for PUCCH:

- 2.1 Retrieve the LO position from the parameter txDirectCurrentLocation in UplinkTxDirectCurrent IE.
- 2.2 PUCCH is set according to Table 6.4D.2.1.4.1-2.
- 2.3 SS transmits PDSCH via PDCCH DCI format 1\_1 for C\_RNTI to transmit the DL RMC according to Table 6.4D.2.1.4.1-2. The SS sends downlink MAC padding bits on the DL RMC. The transmission of PDSCH will make the UE send uplink ACK/NACK using PUCCH. There is no PUSCH transmission.
- 2.4 Set the UE in the Inband Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 2) for the UE Tx beam selection to complete.
- 2.5 SS send appropriate TPC commands for PUCCH to the UE until the UE transmit PUCCH at [P<sub>UMAX</sub> level]. Allow at least 200 ms starting from the first TPC command in this step for the UE to reach [P<sub>UMAX</sub> level]. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 2) for the UE Tx beam selection to complete.
- 2.6 SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition TxRx.

2.7 Measure PUCCH  $EVM_{\theta}$  and PUCCH  $EVM_{\phi}$  using Global In-Channel Tx-Test (Annex E). Calculate  $PUCCH\ EVM = \min(PUCCH\ EVM_{\theta}, PUCCH\ EVM_{\phi})$ .

2.8 SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

NOTE1: When switching to DFT-s-OFDM waveform, as specified in Table 6.4D.2.1.4.1-2, send an NR RRCReconfiguration message according to TS 38.508-1 [10] clause 4.6.3 Table 4.6.3-118 PUSCH-Config with TRANSFORM\_PRECODER\_ENABLED condition.

NOTE 2: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

Test procedure for PRACH:

- 3.1 Retrieve the LO position from the parameter txDirectCurrentLocation in UplinkTxDirectCurrent IE.
- 3.2 Set the UE in the Inband Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1.
- 3.3 The SS shall set RS EPRE according to Table 6.4D.2.1.4.1-3.
- 3.4 PRACH is set according to Table 6.4D.2.1.4.1-3.
- 3.5 The SS shall signal a Random Access Preamble ID via a PDCCH order to the UE and initiate a Non-contention based Random Access procedure.
- 3.6 The UE shall send the signalled preamble to the SS.
- 3.7 In response to the preamble, the SS shall transmit a random access response not corresponding to the transmitted random access preamble, or send no response.
- 3.8 The UE shall consider the random access response reception not successful then re-transmit the preamble with the calculated PRACH transmission power.
- 3.9 Repeat step 3.5 and 3.6 until the SS collect enough PRACH preambles ([2] preambles for format 0 and [10] preambles for format 4). Measure the  $EVM_{\theta}$  and  $EVM_{\phi}$  in PRACH channel using Global In-Channel Tx-Test (Annex E). Calculate  $EVM = \min(EVM_{\theta}, EVM_{\phi})$ .

6.4D.2.1.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 ensuring Table 4.6.3-182 with condition 2TX\_UL\_MIMO, with the following exceptions for PRACH test.

**Table 6.4D.2.1.4.3-1: RACH-ConfigGeneric for PRACH test**

Derivation Path: TS 38.508-1 [10], Table 4.6.3-130			
Information Element	Value/remark	Comment	Condition
RACH-ConfigGeneric ::= SEQUENCE {			
preambleReceivedTargetPower	-60		
powerRampingStep	dB0		
}			

**Table 6.4D.2.1.4.3-2: ServingCellConfigCommon**

Derivation Path: TS 38.508-1 [10], Table 4.6.3-168			
Information Element	Value/remark	Comment	Condition
ServingCellConfigCommon ::= SEQUENCE {			
ss-PBCH-BlockPower	18		
}			

**Table 6.4D.2.1.4.3-3: ServingCellConfigCommonSIB**

Derivation Path: TS 38.508-1 [10], Table 4.6.3-169
--

Information Element	Value/remark	Comment	Condition
ServingCellConfigCommonSIB ::= SEQUENCE {			
ss-PBCH-BlockPower	18		
}			

#### 6.4D.2.1.5 Test requirement

The PUSCH EVM, derived in Annex E.4.2, shall not exceed the values in Table 6.4D.2.1.5-1.

The PUSCH  $\overline{EVM}_{DMRS}$ , derived in Annex E.4.6.2, shall not exceed the values in Table 6.4D.2.1.5-1 when embedded with data symbols of the respective modulation scheme.

The PUCCH EVM derived in Annex E.5.9.2 shall not exceed the values for QPSK in Table 6.4D.2.1.5-1.

The PRACH EVM derived in Annex E.6.9.2 shall not exceed the values for QPSK in Table 6.4D.2.1.5-1.

**Table 6.4D.2.1.5-1: Test requirements for Error Vector Magnitude**

Parameter	Unit	Average EVM Level	Reference Signal EVM Level
Pi/2 BPSK	%	30+TT	30+TT
QPSK	%	17.5+TT	17.5+TT
16 QAM	%	12.5+TT	12.5+TT
64 QAM	%	8+TT	8+TT

#### 6.4D.2.2 Carrier leakage for UL MIMO

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- OTA test procedure for UL MIMO is still under investigation.
- Test config table is FFS.
- TP analysis is FFS.
- Measurement Uncertainty and Test Tolerances are FFS.

##### 6.4D.2.2.1 Test purpose

The purpose of this test is to exercise the UE transmitter to verify its modulation quality in terms of carrier leakage.

##### 6.4D.2.2.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that support UL MIMO.

##### 6.4D.2.2.3 Minimum conformance requirements

For a UE supporting UL MIMO, the Carrier leakage is an additive sinusoid waveform. The carrier leakage requirement is defined for each component carrier. The measurement interval is one slot in the time domain. The relative carrier leakage power is a power ratio of the additive sinusoid waveform to the power in the modulated waveform.

The requirement is verified with the test metric of Carrier Leakage (Link=TX beam peak direction, Meas=Link angle).

When carrier leakage is contained inside the spectrum confined within the configured UL and DL CCs, the relative carrier leakage power shall not exceed the values specified in Table 6.4D.2.2.3-1 for power class 1 UEs.

**Table 6.4D.2.2.3-1: Minimum requirements for relative carrier leakage power for power class 1**

Parameters	Relative Limit (dBc)

EIRP > 17 dBm	-25
4 dBm ≤ EIRP ≤ 17 dBm	-20

When carrier leakage is contained inside the spectrum occupied by the configured UL CCs and DL CCs, the relative carrier leakage power shall not exceed the values specified in Table 6.4D.2.2.3-2 for power class 2.

**Table 6.4D.2.2.3-2: Minimum requirements for relative carrier leakage power for power class 2**

Parameters	Relative Limit (dBc)
EIRP > 6 dBm	-25
-13 dBm ≤ EIRP ≤ 6 dBm	-20

When carrier leakage is contained inside the spectrum occupied by the configured UL CCs and DL CCs, the relative carrier leakage power shall not exceed the values specified in Table 6.4D.2.2.3-3 for power class 3 UEs.

**Table 6.4D.2.2.3-3: Minimum requirements for relative carrier leakage power for power class 3**

Parameters	Relative Limit (dBc)
EIRP > 0 dBm	-25
-13 dBm ≤ EIRP ≤ 0 dBm	-20

When carrier leakage is contained inside the spectrum occupied by the configured UL CCs and DL CCs, the relative carrier leakage power shall not exceed the values specified in Table 6.4D.2.2.3-4 for power class 4.

**Table 6.4D.2.2.3-4: Minimum requirements for relative carrier leakage power for power class 4**

Parameters	Relative Limit (dBc)
EIRP > 11 dBm	-25
-13 dBm ≤ EIRP ≤ 11 dBm	-20

The normative reference for this requirement is TS 38.101-2[3] clause 6.4D.2.

#### 6.4D.2.2.4 Test description

##### 6.4D.2.2.4.1 Initial condition

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, test channel bandwidths and sub-carrier spacing based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each combination of channel bandwidth and sub-carrier spacing, are shown in Table 6.4D.2.2.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.4D.2.2.4.1-1: Test Configuration**

Initial Conditions
--------------------

Test Environment as specified in TS 38.508-1 [10] subclause 4.1		FFS	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1		FFS	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1		FFS	
Test SCS as specified in Table 5.3.5-1			
Test Parameters			
Test ID	Downlink Configuration	Uplink Configuration	
	-	Modulation	RB allocation (NOTE 1, 3)
1			
NOTE 1: NOTE 2: NOTE 3:			

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, in Figure A.3.3.1.1 for TE diagram and section A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement channels are set according to Table 6.4D.2.2.4.1-1.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.4D.2.2.4.3.
7. In case the parameter 3300 or 3301 is reported from the UE via *txDirectCurrentLocation* IE, do not proceed to test procedure and mark the test not applicable with reasoning in the test report.

#### 6.4D.2.2.4.2 Test procedure

1. Retrieve the LO position from the parameter *txDirectCurrentLocation* in UplinkTxDirectCurrent IE.
  2. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.4D.2.2.4.1-1. Since the UE has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC.
  3. Set the UE in the Inband Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
  4. Send uplink power control commands to the UE using 1dB power step size to ensure that the UE  $EIRP_{Total} = EIRP_{\theta} + EIRP_{\phi}$  measured by the test system is within the Uplink power control window, defined as  $+MU$  to  $+(MU + \text{Uplink power control window size})$  dB of the target power level  $P_{req}$ , where:
    - $P_{req}$  is the power level specified in Table 6.4D.2.2.4.2-1 according to the power class.
    - $MU$  is the test system uplink absolute power measurement uncertainty and is specified in Table F.1.2-1 under carrier leakage sub-clause for the carrier frequency  $f$  and the channel bandwidth  $BW$ .
    - Uplink power control window size = 1dB (UE power step size) + 5 dB (UE power step tolerance) + (Test system uplink relative power measurement uncertainty), where, the UE power step tolerance is specified in TS 38.101-1 [2], Table 6.3.4.3-1 and is 5dB for 1dB power step size, and the Test system uplink relative power measurement uncertainty is specified in Table F.1.2-1.
- Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
5. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition TxRx.

6. Measure carrier leakage using Global In-Channel Tx-Test (Annex E) for the  $\theta$ - and  $\phi$ -polarization at the LO position obtained in step 1. For TDD, only slots consisting of only UL symbols are under test. Calculate  $\text{CarrLeak} = \min(\text{CarrLeak}_\theta, \text{CarrLeak}_\phi)$ .
7. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

NOTE 2: The purpose of the Uplink power control window is to ensure that the actual UE output power is no less than the target power level, and as close as possible to the target power level. The relationship between the Uplink power control window, the target power level and the corresponding possible actual UE Uplink power window is illustrated in Annex F.4.2.

**Table 6.4.2.2.4.2-1: UE EIRP  $P_{\text{req}}$  (dBm) for carrier leakage**

Power Class	$P_{\text{req}}$ (dBm) for step 3
Power Class 1	17
Power Class 2	6
Power Class 3	0
Power Class 4	11

**Table 6.4.2.2.4.2-2: Void**

#### 6.4D.2.2.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 ensuring Table 4.6.3-182 with condition 2TX\_UL\_MIMO and with TRANSFORM\_PRECODER\_ENABLED condition in Table 4.6.3-118 PUSCH-Config.

#### 6.4D.2.2.5 Test requirement

For each of the  $n$  carrier leakage results derived in Annex E.3.1 for  $\theta$ - and  $\phi$ -polarization the minimum is calculated according to

$$\text{CarrLeak} = \min(\text{CarrLeak}_\theta, \text{CarrLeak}_\phi), \text{ where}$$

$$n = \begin{cases} 30, & \text{for 60 kHz SCS} \\ 60, & \text{for 120 kHz SCS} \end{cases}$$

Each of the  $n$  carrier leakage results CarrLeak shall not exceed the values in Table 6.4D.2.2.5-1 to Table 6.4D.2.2.5-4. Allocated RBs are not under test.

**Table 6.4D.2.2.5-1a: Test requirements for relative carrier leakage power for power class 1**

Parameter	Relative limit (dBc)
$17 \text{ dBm} + \text{MU} < \text{EIRP} \leq 17 \text{ dBm} + \text{MU} + \text{Uplink power control window size}$	$-25 + \text{TT}$

**Table 6.4D.2.2.5-1b: Test Tolerance (carrier leakage for power class 1)**

Test Metric	FR2a	FR2b
Max device size $\leq 30$ cm	TBD	TBD

**Table 6.4D.2.2.5-2a: Test requirements for relative carrier leakage power for power class 2**

Parameter	Relative limit (dBc)
$6 \text{ dBm} + \text{MU} < \text{EIRP} \leq 6 \text{ dBm} + \text{MU} + \text{Uplink power}$ control window size	$-25 + \text{TT}$

**Table 6.4D.2.2.5-2b: Test Tolerance (carrier leakage for power class 2)**

Test Metric	FR2a	FR2b
Max device size $\leq 30 \text{ cm}$	TBD	TBD

**Table 6.4D.2.2.5-3a: Test requirements for relative carrier leakage power for power class 3**

Parameter	Relative limit (dBc)
$0 \text{ dBm} + \text{MU} < \text{EIRP} \leq 0 \text{ dBm} + \text{MU} + \text{Uplink power}$ control window size	$-25 + \text{TT}$

**Table 6.4D.2.2.5-3b: Test Tolerance (carrier leakage for power class 3)**

Test Metric	FR2a	FR2b
Max device size $\leq 30 \text{ cm}$	TBD	TBD

**Table 6.4D.2.2.5-4a: Test requirements for relative carrier Leakage Power for power class 4**

Parameter	Relative limit (dBc)
$11 \text{ dBm} + \text{MU} < \text{EIRP} \leq 11 \text{ dBm} + \text{MU} + \text{Uplink power}$ control window size	$-25 + \text{TT}$

**Table 6.4D.2.2.5-4b: Test Tolerance (carrier leakage for power class 4)**

Test Metric	FR2a	FR2b
Max device size $\leq 30 \text{ cm}$	TBD	TBD

### 6.4D.2.3 In-band emissions for UL MIMO

Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:

- OTA test procedure for UL MIMO is still under investigation.
- Test config table is FFS.
- TP analysis is FFS.
- Measurement Uncertainty and Test Tolerances are FFS.

#### 6.4D.2.3.1 Test purpose

The purpose of this test is to exercise the UE transmitter to verify its modulation quality in terms of in-band emissions.

#### 6.4D.2.3.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that support UL MIMO.



6.4D.2.3.3 Minimum conformance requirements

For a UE supporting UL MIMO, the in-band emission is defined as the average across 12 sub-carriers and as a function of the RB offset from the edge of the allocated UL transmission bandwidth. The in-band emission is measured as the ratio of the UE output power in a non-allocated RB to the UE output power in an allocated RB. The IBE requirement does not apply if UE declares support for *mpr-PowerBoost-FR2-r16*, UL transmission excluding Pi/2 BPSK is such that  $MPR_{f,c} = 0$  and when NS\_200 applies, and the network configures the UE to operate with *mpr-PowerBoost-FR2-r16*.

The basic in-band emissions measurement interval is identical to that of the EVM test.

The requirement is verified with the test metric of In-band emission (Link=TX beam peak direction, Meas=Link angle).

The relative in-band emission shall not exceed the values specified in Table 6.4D.2.3.3-1 for power class 1 UEs.

The average of the in-band emission measurement over 10 sub-frames shall not exceed the values specified in Table 6.4D.2.3.3-1 for power class 1, Table 6.4D.2.3.3-2 for power class 2, Table 6.4D.2.3.3-3 for power class 3 and Table 6.4D.2.3.3-4 for power class 4 UEs.

**Table 6.4D.2.3.3-1: Requirements for in-band emissions for power class 1**

Parameter description	Unit	Limit (NOTE 1)		Applicable Frequencies
General	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10} (EVM) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right]$		Any non-allocated (NOTE 2)
IQ Image	dB	-25	Output power > 27 dBm	Image frequencies (NOTES 2, 3)
		-20	Output power ≤ 27 dBm	
Carrier leakage	dBc	-25	Output power > 17 dBm	Carrier frequency (NOTES 4, 5)
		-20	4 dBm ≤ Output power ≤ 17 dBm	
<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB} - 25</math> dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 10.</p> <p>NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD</p> <p>NOTE 3: The applicable frequencies for this limit are those that are enclosed in the reflection of the allocated bandwidth, based on symmetry with respect to the carrier frequency, but excluding any allocated RBs.</p> <p>NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.</p> <p>NOTE 5: The applicable frequencies for this limit depend on the parameter <i>txDirectCurrentLocation</i> in <i>UplinkTxDirectCurrent</i> IE, and are those that are enclosed in the RBs containing the DC frequency but excluding any allocated RB.</p> <p>NOTE 6: <math>L_{CRB}</math> is the Transmission Bandwidth (see Section 5.3).</p> <p>NOTE 7: <math>N_{RB}</math> is the Transmission Bandwidth Configuration (see Section 5.3).</p> <p>NOTE 8: EVM is the limit for the modulation format used in the allocated RBs.</p> <p>NOTE 9: <math>\Delta_{RB}</math> is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g. <math>\Delta_{RB} = 1</math> or <math>\Delta_{RB} = -1</math> for the first adjacent RB outside of the allocated bandwidth).</p> <p>NOTE 10: <math>P_{RB}</math> is the transmitted power per allocated RB, measured in dBm.</p> <p>NOTE 11: All powers are EIRP in beam peak direction.</p>				

The relative in-band emission shall not exceed the values specified in Table 6.4D.2.3.3-2 for power class 2.

**Table 6.4D.2.3.3-2: Requirements for in-band emissions for power class 2**

Parameter description	Unit	Limit (NOTE 1)	Applicable Frequencies
-----------------------	------	----------------	------------------------

<b>General</b>	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10}(\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right]$		Any non-allocated (NOTE 2)
<b>IQ Image</b>	dB	-25	Output power > 16 dBm	Image frequencies (NOTES 2, 3)
		-20	Output power ≤ 16 dBm	
<b>Carrier leakage</b>	dBc	-25	Output power > 6 dBm	Carrier frequency (NOTES 4, 5)
		-20	-13 dBm ≤ Output power ≤ 6 dBm	
<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB} - 25</math> dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 10.</p> <p>NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD</p> <p>NOTE 3: The applicable frequencies for this limit are those that are enclosed in the reflection of the allocated bandwidth, based on symmetry with respect to the carrier frequency, but excluding any allocated RBs.</p> <p>NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.</p> <p>NOTE 5: The applicable frequencies for this limit depend on the parameter <i>txDirectCurrentLocation</i> in <i>UplinkTxDirectCurrent</i> IE, and are those that are enclosed in the RBs containing the DC frequency but excluding any allocated RB.</p> <p>NOTE 6: <math>L_{CRB}</math> is the Transmission Bandwidth (see Section 5.3).</p> <p>NOTE 7: <math>N_{RB}</math> is the Transmission Bandwidth Configuration (see Section 5.3).</p> <p>NOTE 8: EVM is the limit for the modulation format used in the allocated RBs.</p> <p>NOTE 9: <math>\Delta_{RB}</math> is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g. <math>\Delta_{RB} = 1</math> or <math>\Delta_{RB} = -1</math> for the first adjacent RB outside of the allocated bandwidth).</p> <p>NOTE 10: <math>P_{RB}</math> is the transmitted power per allocated RB, measured in dBm.</p> <p>NOTE 11: All powers are EIRP in beam peak direction.</p>				

The relative in-band emission shall not exceed the values specified in Table 6.4D.2.3.3-3 for power class 3 UEs.

**Table 6.4D.2.3.3-3: Requirements for in-band emissions for power class 3**

Parameter description	Unit	Limit (NOTE 1)		Applicable Frequencies
<b>General</b>	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10}(\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right]$		Any non-allocated (NOTE 2)
<b>IQ Image</b>	dB	-25	Output power > 10 dBm	Image frequencies (NOTES 2, 3)
		-20	Output power ≤ 10 dBm	
<b>Carrier leakage</b>	dBc	-25	Output power > 0 dBm	Carrier frequency (NOTES 4, 5)
		-20	-13 dBm ≤ Output power ≤ 0 dBm	
<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB} - 25</math> dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 10.</p> <p>NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD</p> <p>NOTE 3: The applicable frequencies for this limit are those that are enclosed in the reflection of the allocated bandwidth, based on symmetry with respect to the carrier frequency, but excluding any allocated RBs.</p> <p>NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.</p>				

NOTE 5: The applicable frequencies for this limit depend on the parameter *txDirectCurrentLocation* in *UplinkTxDirectCurrent* IE, and are those that are enclosed in the RBs containing the DC frequency but excluding any allocated RB.

NOTE 6:  $L_{CRB}$  is the Transmission Bandwidth (see Section 5.3).

NOTE 7:  $N_{RB}$  is the Transmission Bandwidth Configuration (see Section 5.3).

NOTE 8: EVM is the limit for the modulation format used in the allocated RBs.

NOTE 9:  $\Delta_{RB}$  is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g.  $\Delta_{RB}= 1$  or  $\Delta_{RB}= -1$  for the first adjacent RB outside of the allocated bandwidth).

NOTE 10:  $P_{RB}$  is the transmitted power per allocated RB, measured in dBm.

NOTE 11: All powers are EIRP in beam peak direction.

The relative in-band emission shall not exceed the values specified in Table 6.4D.2.3.3-4 for power class 4 UEs.

**Table 6.4D.2.3.3-4: Requirements for in-band emissions for power class 4**

Parameter description	Unit	Limit (NOTE 1)		Applicable Frequencies
General	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10}(\text{EVM}) - 5 \cdot \frac{( \Delta_{RB}  - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right]$		Any non-allocated (NOTE 2)
IQ Image	dB	-25	Output power > 21 dBm	Image frequencies (NOTES 2, 3)
		-20	Output power ≤ 21 dBm	
Carrier leakage	dBc	-25	Output power > 11 dBm	Carrier frequency (NOTES 4, 5)
		-20	-13 dBm ≤ Output power ≤ 11 dBm	
<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB} - 25</math> dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 10.</p> <p>NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD</p> <p>NOTE 3: The applicable frequencies for this limit are those that are enclosed in the reflection of the allocated bandwidth, based on symmetry with respect to the carrier frequency, but excluding any allocated RBs.</p> <p>NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.</p> <p>NOTE 5: The applicable frequencies for this limit depend on the parameter <i>txDirectCurrentLocation</i> in <i>UplinkTxDirectCurrent</i> IE, and are those that are enclosed in the RBs containing the DC frequency but excluding any allocated RB.</p> <p>NOTE 6: <math>L_{CRB}</math> is the Transmission Bandwidth (see Section 5.3).</p> <p>NOTE 7: <math>N_{RB}</math> is the Transmission Bandwidth Configuration (see Section 5.3).</p> <p>NOTE 8: EVM is the limit for the modulation format used in the allocated RBs.</p> <p>NOTE 9: <math>\Delta_{RB}</math> is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g. <math>\Delta_{RB}= 1</math> or <math>\Delta_{RB}= -1</math> for the first adjacent RB outside of the allocated bandwidth).</p> <p>NOTE 10: <math>P_{RB}</math> is the transmitted power per allocated RB, measured in dBm.</p> <p>NOTE 11: All powers are EIRP in beam peak direction.</p>				

The normative reference for this requirement is TS 38.101-2 [3] clause 6.4D.2.

## 6.4D.2.3.4 Test description

## 6.4D.2.3.4.1 Initial condition

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, test channel bandwidths and sub-carrier spacing based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each combination of channel bandwidth and sub-carrier spacing, are shown in Table 6.4D.2.3.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annex A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.4D.2.3.4.1-1: Test Configuration Table for PUSCH**

Initial Conditions			
Test Environment as specified in TS 38.508-1 [10] subclause 4.1		FFS	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1			
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1			
Test SCS as specified in Table 5.3.5-1			
Test Parameters			
Test ID	Downlink Configuration		Uplink Configuration
	-		Modulation
1			FFS
2			
3			
4			
NOTE 1: FFS			
NOTE 2: FFS			

**Table 6.4D.2.3.4.1-2: Test Configuration Table for PUCCH**

Initial Conditions			
Test Environment as specified in TS 38.508-1 [10] subclause 4.1		FFS	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1			
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1			
Test SCS as specified in Table 5.3.5-1			
Test Parameters			
ID	Downlink Configuration		Uplink Configuration
	Modulation	RB allocation	Waveform
1			FFS
2			
NOTE 1: FFS			

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, in Figure A.3.3.1.1 for TE diagram and section A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement channels are set according to Table 6.4D.2.3.4.1-1.
5. Propagation conditions are set according to Annex B.0.

6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.4D.2.3.4.3

#### 6.4D.2.3.4.2 Test procedure

Test procedure for PUSCH:

1.1 Retrieve the LO position from the parameter txDirectCurrentLocation in UplinkTxDirectCurrent IE.

1.2 SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.4D.2.3.4.1-1. Since the UE has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC.

1.3 Set the UE in the Inband Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 2) for the UE Tx beam selection to complete.

1.4 Send the appropriate TPC commands in the uplink scheduling information to the UE until UE output power is  $P_{req} + P_W \pm P_W$ , where  $P_{req}$  is the power level specified in Tables 6.4D.2.3.4.2-1 according to the power class with power ID = 1.  $P_W$  is the power window according to Table 6.4D.2.3.4.2-2 for the carrier frequency  $f$  and the channel bandwidth  $BW$ . Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 2) for the UE Tx beam selection to complete.

1.5 SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition TxRx.

1.6 Measure In-band emission  $IE_\theta$ ,  $IE_\phi$  using Global In-Channel Tx-Test (Annex E) for the  $\theta$ - and  $\phi$ -polarizations, respectively. For TDD, only slots consisting of only UL symbols are under test. Calculate  $IE = IE_\theta + IE_\phi$ , where the calculation is based on linear power ratios.

1.7 SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

1.8 Repeat steps 1.3 through 1.6 until In-band emissions have been measured for all power IDs in Table 6.4D.2.3.4.2-1.

NOTE 1: When switching to DFT-s-OFDM waveform, as specified in Table 6.4D.2.3.4.1-1, send an NR RRCReconfiguration message according to TS 38.508-1 [10] clause 4.6.3 Table 4.6.3-118 PUSCH-Config with TRANSFORM\_PRECODER\_ENABLED condition.

NOTE 2: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

**Table 6.4D.2.3.4.2-1: Parameters for In-band emissions**

Power ID	Unit	Level for power class 1	Level for power class 2	Level for power class 3	Level for power class 4
1	dBm	27	16	10	21
2	dBm	17	6	0	11

**Table 6.4D.2.3.4.2-2: Power Window (dB) for In-band emissions PUSCH and PUCCH**

TBD

Test procedure for PUCCH:

2.1 Retrieve the LO position from the parameter txDirectCurrentLocation in UplinkTxDirectCurrent IE.

2.2 PUCCH is set according to Table 6.4D.2.3.4.1-2. SS transmits PDSCH via PDCCH DCI format 1\_1 for C\_RNTI to transmit the DL RMC according to Table 6.4D.2.3.4.1-2. The SS sends downlink MAC padding bits on the DL RMC. The transmission of PDSCH will make the UE send uplink ACK/NACK using PUCCH.

2.3 Set the UE in the Inband Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.

2.4 Send the appropriate TPC commands in the uplink scheduling information for PUCCH to the UE until UE output power is  $P_{req} + P_W \pm P_W$ , where  $P_{req}$  is the power level specified in Tables 6.4D.2.3.4.2-1 according to the power class with power ID = 1.  $P_W$  is the power window according to Table 6.4D.2.3.4.2-2 for the carrier frequency  $f$  and the channel bandwidth  $BW$ . Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.

2.5 SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition TxRx.

2.6 Measure In-band emission  $IE_\theta$ ,  $IE_\phi$  using Global In-Channel Tx-Test (Annex E) for the  $\theta$ - and  $\phi$ -polarizations, respectively. Calculate  $IE = IE_\theta + IE_\phi$ , where the calculation is based on linear power ratios.

2.7 SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

2.8 Repeat steps 2.3 through 2.6 until In-band emissions have been measured for all power IDs in Table 6.4D.2.3.4.2-1.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

NOTE 2: When switching to DFT-s-OFDM waveform, as specified in Table 6.4D.2.3.4.1-1, send an NR RRCReconfiguration message according to TS 38.508-1 [10] clause 4.6.3 Table 4.6.3-118 PUSCH-Config with TRANSFORM\_PRECODER\_ENABLED condition.

6.4.2.3.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 ensuring Table 4.6.3-182 with condition 2TX\_UL\_MIMO.

6.4.2.3.5 Test requirement

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4D.2.3.5-1 for power class 1 UEs.

**Table 6.4D.2.3.5-1: Test requirements for in-band emissions for power class 1**

Parameter description	Unit	Limit (NOTE 1)		Applicable Frequencies
General (NOTE 12)	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10} (EVM) - 5 \cdot \frac{(\Delta_{RB} - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{Tx} \end{array} \right] + TT$		Any non-allocated (NOTE 2)
IQ Image (NOTE 12)	dB	-25+TT	Output power > 27 dBm	Image frequencies (NOTES 2, 3)
		-20+TT	Output power ≤ 27 dBm	
Carrier leakage (NOTE 12)	dBc	-25+TT	Output power > 17 dBm	Carrier frequency (NOTES 4, 5)
		-20+TT	4 dBm ≤ Output power ≤ 17 dBm	
<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB} - 25</math> dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 10.</p> <p>NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD</p> <p>NOTE 3: The applicable frequencies for this limit are those that are enclosed in the reflection of the allocated bandwidth, based on symmetry with respect to the carrier frequency, but excluding any allocated RBs.</p> <p>NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.</p> <p>NOTE 5: The applicable frequencies for this limit depend on the parameter <i>txDirectCurrentLocation</i> in <i>UplinkTxDirectCurrent</i> IE, and are those that are enclosed in the RBs containing the DC but excluding any allocated RB.</p> <p>NOTE 6: <math>L_{CRB}</math> is the Transmission Bandwidth (see Section 5.3).</p>				

NOTE 7:  $N_{RB}$  is the Transmission Bandwidth Configuration (see Section 5.3).  
 NOTE 8: EVM is the limit for the modulation format used in the allocated RBs.  
 NOTE 9:  $\Delta_{RB}$  is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g.  $\Delta_{RB} = 1$  or  $\Delta_{RB} = -1$  for the first adjacent RB outside of the allocated bandwidth).  
 NOTE 10:  $P_{RB}$  is the transmitted power per allocated RB, measured in dBm.  
 NOTE 11: All powers are EIRP in beam peak direction.  
 NOTE 12: In case the parameter 3300 or 3301 is reported from UE via *txDirectCurrentLocation* IE, IQ Image and Carrier leakage limit do not apply and General limit applies for all non-allocated frequencies.

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4D.2.3.5-2 for power class 2 UEs.

**Table 6.4D.2.3.5-2: Test requirements for in-band emissions for power class 2**

Parameter description	Unit	Limit (NOTE 1)		Applicable Frequencies
General (NOTE 12)	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10}(\text{EVM}) - 5 \cdot \frac{(\Delta_{RB} - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right] + TT$		Any non-allocated (NOTE 2)
IQ Image (NOTE 12)	dB	-25 + TT	Output power > 16 dBm	Image frequencies (NOTES 2, 3)
		-20 + TT	Output power ≤ 16 dBm	
Carrier leakage (NOTE 12)	dBc	-25 + TT	Output power > 6 dBm	Carrier frequency (NOTES 4, 5)
		-20 + TT	-13 dBm ≤ Output power ≤ 6 dBm	
NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of ( $P_{RB} - 25$ dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. $P_{RB}$ is defined in NOTE 10. NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD NOTE 3: The applicable frequencies for this limit are those that are enclosed in the reflection of the allocated bandwidth, based on symmetry with respect to the carrier frequency, but excluding any allocated RBs. NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs. NOTE 5: The applicable frequencies for this limit depend on the parameter <i>txDirectCurrentLocation</i> in <i>UplinkTxDirectCurrent</i> IE, and are those that are enclosed in the RBs containing the DC frequency if $N_{RB}$ is odd, or in the two RBs immediately adjacent to the DC frequency if $N_{RB}$ is even but excluding any allocated RB. NOTE 6: $L_{CRB}$ is the Transmission Bandwidth (see Section 5.3). NOTE 7: $N_{RB}$ is the Transmission Bandwidth Configuration (see Section 5.3). NOTE 8: EVM is the limit for the modulation format used in the allocated RBs. NOTE 9: $\Delta_{RB}$ is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g. $\Delta_{RB} = 1$ or $\Delta_{RB} = -1$ for the first adjacent RB outside of the allocated bandwidth). NOTE 10: $P_{RB}$ is the transmitted power per allocated RB, measured in dBm. NOTE 11: All powers are EIRP in beam peak direction. NOTE 12: In case the parameter 3300 or 3301 is reported from UE via <i>txDirectCurrentLocation</i> IE, IQ Image and Carrier leakage limit do not apply and General limit applies for all non-allocated frequencies.				

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4D.2.3.5-3 for power class 3 UEs.

**Table 6.4D.2.3.5-3: Requirements for in-band emissions for power class 3**

Parameter description	Unit	Limit (NOTE 1)	Applicable Frequencies
General (NOTE 12)	dB		Any non-allocated (NOTE 2)

		$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10} (EVM) - 5 \cdot \frac{(\Delta_{RB} - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right] + TT$		
IQ Image (NOTE 12)	dB	-25+TT	Output power > 10 dBm	Image frequencies (NOTES 2, 3)
		-20+TT	Output power ≤ 10 dBm	
Carrier leakage (NOTE 12)	dBc	-25+TT	Output power > 0 dBm	Carrier frequency (NOTES 4, 5)
		-20+TT	-13 dBm ≤ Output power ≤ 0 dBm	
<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB}</math> - 25 dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 10.</p> <p>NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD.</p> <p>NOTE 3: The applicable frequencies for this limit are those that are enclosed in the reflection of the allocated bandwidth, based on symmetry with respect to the carrier frequency, but excluding any allocated RBs.</p> <p>NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.</p> <p>NOTE 5: The applicable frequencies for this limit depend on the parameter <i>txDirectCurrentLocation</i> in <i>UplinkTxDirectCurrent</i> IE, and are those that are enclosed in the RBs containing the DC but excluding any allocated RB.</p> <p>NOTE 6: <math>L_{CRB}</math> is the Transmission Bandwidth (see Section 5.3).</p> <p>NOTE 7: <math>N_{RB}</math> is the Transmission Bandwidth Configuration (see Section 5.3).</p> <p>NOTE 8: EVM is the limit for the modulation format used in the allocated RBs.</p> <p>NOTE 9: <math>\Delta_{RB}</math> is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g. <math>\Delta_{RB} = 1</math> or <math>\Delta_{RB} = -1</math> for the first adjacent RB outside of the allocated bandwidth).</p> <p>NOTE 10: <math>P_{RB}</math> is the transmitted power per allocated RB, measured in dBm.</p> <p>NOTE 11: All powers are EIRP in beam peak direction.</p> <p>NOTE 12: In case the parameter 3300 or 3301 is reported from UE via <i>txDirectCurrentLocation</i> IE, IQ Image and Carrier leakage limit do not apply and General limit applies for all non-allocated frequencies.</p>				

For power ID1 and ID2, the averaged in-band emissions result, derived in Annex E.4.3 shall not exceed the corresponding values for IQ Image and Carrier Leakage in Table 6.4D.2.3.5-4 for power class 4 UEs.

**Table 6.4D.2.3.5-4: Test requirements for in-band emissions for power class 4**

Parameter description	Unit	Limit (NOTE 1)		Applicable Frequencies
General (NOTE 12)	dB	$\max \left[ \begin{array}{l} -25 - 10 \cdot \log_{10} \left( \frac{N_{RB}}{L_{CRB}} \right), \\ 20 \cdot \log_{10} (EVM) - 5 \cdot \frac{(\Delta_{RB} - 1)}{L_{CRB}}, \\ -55.1 \text{ dBm} - P_{RB} \end{array} \right] + TT$		Any non-allocated (NOTE 2)
IQ Image (NOTE 12)	dB	-25 + TT	Output power > 21 dBm	Image frequencies (NOTES 2, 3)
		-20 + TT	Output power ≤ 21 dBm	
Carrier leakage (NOTE 12)	dBc	-25 + TT	Output power > 11 dBm	Carrier frequency (NOTES 4, 5)
		-20 + TT	-13 dBm ≤ Output power ≤ 11 dBm	
<p>NOTE 1: An in-band emissions combined limit is evaluated in each non-allocated RB. For each such RB, the minimum requirement is calculated as the higher of (<math>P_{RB}</math> - 25 dB) and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply. <math>P_{RB}</math> is defined in NOTE 10.</p> <p>NOTE 2: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured average power per allocated RB, where the averaging is done across all allocated RBs. For pi/2 BPSK with Spectrum Shaping, the limit is expressed as a ratio of measured power in one non-allocated RB to the measured power in the allocated RB with highest PSD</p> <p>NOTE 3: The applicable frequencies for this limit are those that are enclosed in the reflection of the allocated bandwidth,</p>				



based on symmetry with respect to the carrier frequency, but excluding any allocated RBs.

NOTE 4: The measurement bandwidth is 1 RB and the limit is expressed as a ratio of measured power in one non-allocated RB to the measured total power in all allocated RBs.

NOTE 5: The applicable frequencies for this limit depend on the parameter *txDirectCurrentLocation* in *UplinkTxDirectCurrent* IE, and are those that are enclosed in the RBs containing the DC frequency but excluding any allocated RB.

NOTE 6:  $L_{\text{CRB}}$  is the Transmission Bandwidth (see Section 5.3).

NOTE 7:  $N_{\text{RB}}$  is the Transmission Bandwidth Configuration (see Section 5.3).

NOTE 8: EVM is the limit for the modulation format used in the allocated RBs.

NOTE 9:  $\Delta_{\text{RB}}$  is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g.  $\Delta_{\text{RB}} = 1$  or  $\Delta_{\text{RB}} = -1$  for the first adjacent RB outside of the allocated bandwidth).

NOTE 10:  $P_{\text{RB}}$  is the transmitted power per allocated RB, measured in dBm.

NOTE 11: All powers are EIRP in beam peak direction.

NOTE 12: In case the parameter 3300 or 3301 is reported from UE via *txDirectCurrentLocation* IE, IQ Image and Carrier leakage limit do not apply and General limit applies for all non-allocated frequencies.

## 6.4D.2.4 EVM equalizer spectrum flatness for UL MIMO

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- OTA test procedure for UL MIMO is still under investigation.
- Test config table is FFS.
- TP analysis is FFS.
- Measurement Uncertainty and Test Tolerances are FFS.

### 6.4D.2.4.1 Test purpose

The zero-forcing equalizer correction applied in the EVM measurement process (as described in Annex E) must meet a spectral flatness requirement for the EVM measurement to be valid.

### 6.4D.2.4.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that support UL MIMO.

### 6.4D.2.4.3 Minimum conformance requirements

For pi/2 BPSK modulation, the minimum requirements are defined in Clause 6.4D.2.5.3.

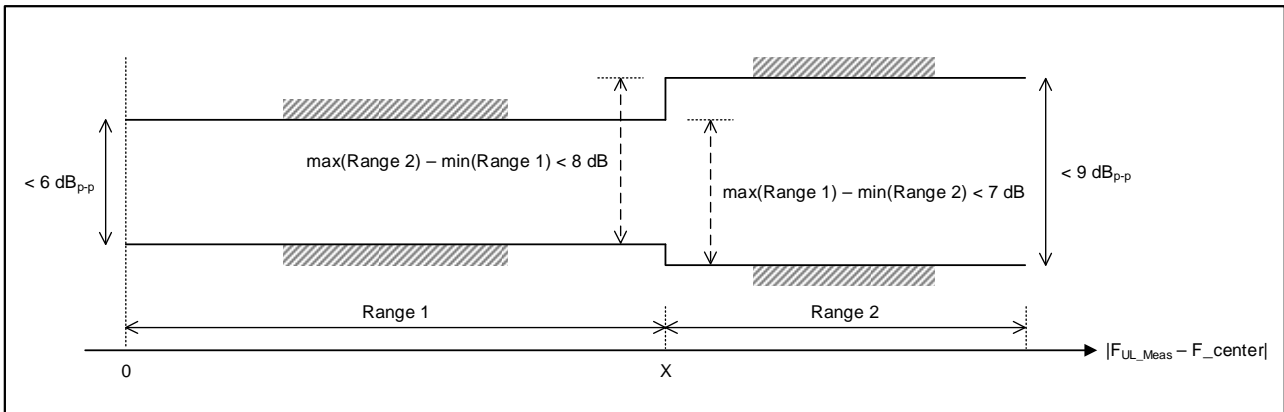
For a UE supporting UL MIMO, the peak-to-peak variation of the EVM equalizer coefficients contained within the frequency range of the uplink allocation shall not exceed the maximum ripple specified in Table 6.4D.2.4.3-1 for normal conditions. For uplink allocations contained within both Range 1 and Range 2, the coefficients evaluated within each of these frequency ranges shall meet the corresponding ripple requirement and the following additional requirements: the relative difference between the maximum coefficient in Range 1 and the minimum coefficient in Range 2 (Table 6.4D.2.4.3-1) must not be larger than 7 dB, and the relative difference between the maximum coefficient in Range 2 and the minimum coefficient in Range 1 must not be larger than 8 dB (see Figure 6.4D.2.4.3-1).

The requirement is verified with the test metric of EVM SF (Link=TX beam peak direction, Meas=Link angle).

**Table 6.4D.2.4.3-1: Minimum requirements for EVM equalizer spectrum flatness (normal conditions)**

Frequency range	Maximum ripple (dB)
$ f_{\text{UL\_Meas}} - f_{\text{center}}  \leq X \text{ MHz}$ (Range 1)	6 (p-p)
$ f_{\text{UL\_Meas}} - f_{\text{center}}  > X \text{ MHz}$ (Range 2)	9 (p-p)
NOTE 1: $f_{\text{UL\_Meas}}$ refers to the sub-carrier frequency for which the equalizer coefficient is evaluated	

NOTE 2:  $F_{center}$  refers to the centre frequency of the CC  
 NOTE 3:  $X$ , in MHz, is equal to 30% of the CC bandwidth



**Figure 6.4D.2.4.3-1: The limits for EVM equalizer spectral flatness with the maximum allowed variation of the coefficients indicated under normal conditions**

The normative reference for this requirement is TS 38.101-2 [3] clause 6.4D.2.

6.4D.2.4.4 Test description

6.4D.2.4.4.1 Initial condition

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, test channel bandwidths and sub-carrier spacing based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each combination of channel bandwidth and sub-carrier spacing, are shown in Table 6.4D.2.4.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annex A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.4D.2.4.4.1-1: Test Configuration**

Initial Conditions			
Test Environment as specified in TS 38.508-1 [10] subclause 4.1		FFS	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1			
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1			
Test SCS as specified in Table 5.3.5-1			
Test Parameters			
Test ID	Downlink Configuration	Uplink Configuration	
	-	Modulation	RB allocation (NOTE 1)
1		FFS	
2			
NOTE 1:			

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, in Figure A.3.3.1.1 for TE diagram and section A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.

4. The UL Reference Measurement channels are set according to Table 6.4D.2.4.4.1-1.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.4D.2.4.4.3

#### 6.4D.2.4.4.2 Test procedure

1. Retrieve the LO position from the parameter txDirectCurrentLocation in UplinkTxDirectCurrent IE.
2. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.4D.2.4.4.1-1. Since the UE has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC
3. Set the UE in the Inband Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 2) for the UE Tx beam selection to complete.
4. Send continuously uplink power control "up" commands in the uplink scheduling information to the UE until the UE transmits at P<sub>UMAX</sub> level. Allow at least 200 ms for the UE to reach P<sub>UMAX</sub> level. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 2) for the UE Tx beam selection to complete.
5. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition TxRx.
6. Measure spectrum flatness using Global In-Channel Tx-Test (Annex E) for the  $\theta$ - and  $\phi$ -polarizations, respectively. For TDD, only slots consisting of only UL symbols are under test.
7. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

NOTE1: When switching to DFT-s-OFDM waveform, as specified in Table 6.4D.2.4.4.1-1, send an NR RRCReconfiguration message according to TS 38.508-1 [10] clause 4.6.3 Table 4.6.3-118 PUSCH-Config with TRANSFORM\_PRECODER\_ENABLED condition.

NOTE 2: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

#### 6.4D.2.4.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 ensuring Table 4.6.3-182 with condition 2TX\_UL\_MIMO.

#### 6.4D.2.4.5 Test requirement

Each of the  $n$  spectrum flatness functions, shall derive four ripple results in Annex E.4.4. The derived results shall not exceed the values in Figure 6.4D.2.4.5-1: The peak-to-peak variation of the EVM equalizer coefficients contained within the frequency range of the uplink allocation shall not exceed the maximum ripple specified in Table 6.4D.2.4.5-1 for normal conditions. For uplink allocations contained within both Range 1 and Range 2, the coefficients evaluated within each of these frequency ranges shall meet the corresponding ripple requirement and the following additional requirements: the relative difference between the maximum coefficient in Range 1 and the minimum coefficient in Range 2 (Table 6.4D.2.4.5-1) must not be larger than 7 dB + TT, and the relative difference between the maximum coefficient in Range 2 and the minimum coefficient in Range 1 must not be larger than 8 dB + TT (see Figure 6.4D.2.4.5-1).

The UE passes the test when the derived results for at least one polarization fulfil the test requirements.

**Table 6.4D.2.4.5-1: Test requirements for EVM equalizer spectrum flatness (normal conditions)**

Frequency range	Maximum ripple (dB)
$ F_{UL\_Meas} - F_{center}  \leq X$ MHz (Range 1)	6 + TT (p-p)
$ F_{UL\_Meas} - F_{center}  > X$ MHz (Range 2)	9 + TT (p-p)

NOTE 1:  $F_{UL\_Meas}$  refers to the sub-carrier frequency for which the equalizer coefficient is evaluated  
 NOTE 2:  $F_{center}$  refers to the centre frequency of the CC  
 NOTE 3:  $X$ , in MHz, is equal to 30% of the CC bandwidth

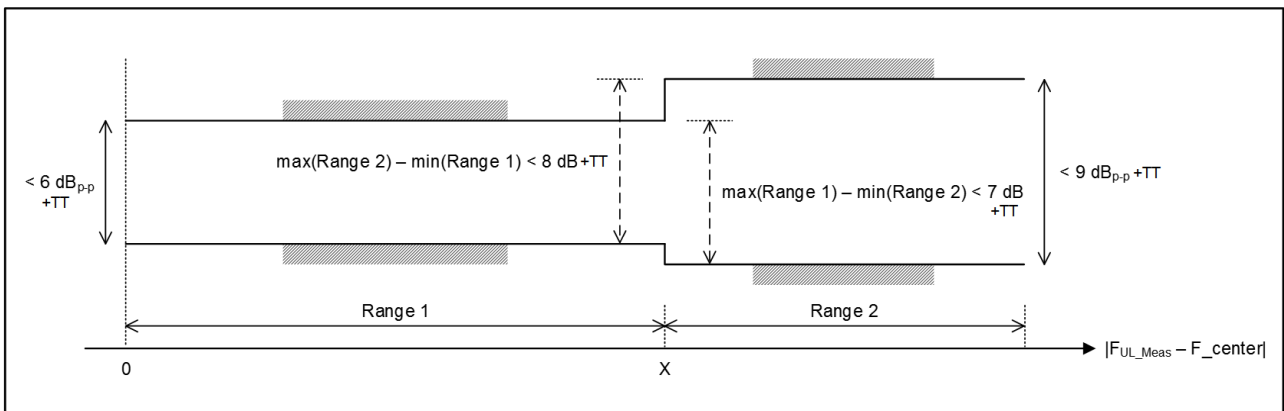


Figure 6.4D.2.4.5-1: The limits for EVM equalizer spectral flatness with the maximum allowed variation of the coefficients indicated under normal conditions

6.4D.2.5 EVM spectral flatness for pi/2 BPSK modulation

Editor’s note: This clause is incomplete. The following aspects are either missing or not yet determined:

- Measurement Uncertainty and Test Tolerance are FFS.
- Whether and, if yes, how to test the requirement on shaping filter is FFS.
- Test config table is FFS.
- TP analysis is FFS.

6.4D.2.5.1 Test purpose

Same test purpose as in clause 6.4D.2.4.1.

6.4D.2.5.2 Test applicability

This test case applies to all types of NR FR2 UE release 15 and forward that support pi/2 BPSK modulation and UL MIMO.

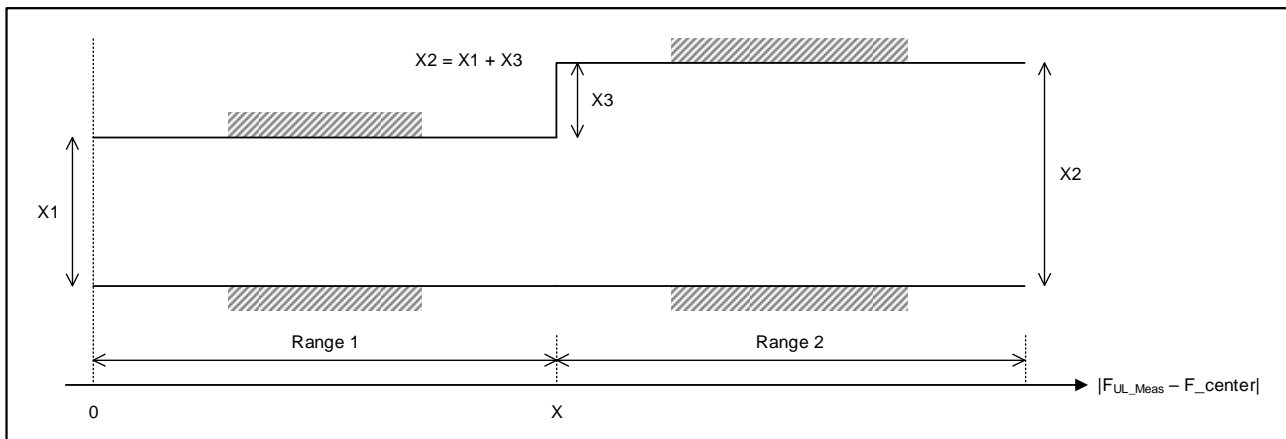
6.4D.2.5.3 Minimum conformance requirements

For a UE supporting UL MIMO, these requirements are defined for pi/2 BPSK modulation. The EVM equalizer coefficients across the allocated uplink block shall be modified to fit inside the mask specified in Table 6.4D.2.5.3-1 for normal conditions, prior to the calculation of EVM. The limiting mask shall be placed to minimize the change in equalizer coefficients in a sum of squares sense.

Table 6.4D.2.5.3-1: Mask for EVM equalizer coefficients for pi/2 BPSK (normal conditions)

Frequency range	Parameter	Maximum ripple (dB)
$ F_{UL\_Meas} - F_{center}  \leq X$ MHz (Range 1)	X1	6 (p-p)
$ F_{UL\_Meas} - F_{center}  > X$ MHz (Range 2)	X2	14 (p-p)
NOTE 1: $F_{UL\_Meas}$ refers to the sub-carrier frequency for which the equalizer coefficient is evaluated. NOTE 2: $F_{center}$ refers to the centre frequency of an allocated block of PRBs.		

NOTE 3: X, in MHz, is equal to 25% of the bandwidth of the PRB allocation.  
 NOTE 4: See Figure 6.4D.2.5.3-1 for description of X1, X2 and X3.



**Figure 6.4D.2.5.3-1: The limits for EVM equalizer spectral flatness with the maximum allowed variation.  $F_{center}$  denotes the centre frequency of the allocated block of PRBs.  $F_{alloc}$  denotes the bandwidth of the PRB allocation**

This requirement does not apply to other modulation types. The UE shall be allowed to employ spectral shaping for  $\pi/2$  BPSK. The shaping filter shall be restricted so that the impulse response of the transmit chain shall meet

$$|\tilde{a}_t(t,0)| \geq |\tilde{a}_t(t,\tau)| \quad \forall \tau \neq 0$$

$$20\log_{10} |\tilde{a}_t(t,\tau)| < -15 \text{ dB} \quad 1 < \tau < M - 1,$$

Where:

$$|\tilde{a}_t(t,\tau)| = \text{IDFT} \{ |\tilde{a}_t(t,f)| e^{j\varphi(t,f)} \},$$

f is the frequency of the M allocated subcarriers,

$\tilde{a}_t(t,f)$  and  $\varphi(t,f)$  are the amplitude and phase response, respectively of the transmit chain

0dB reference is defined as  $20\log_{10} |\tilde{a}_t(t,0)|$

The normative reference for this requirement is TS 38.101-2 [3] clause 6.4.2.5.

6.4D.2.5.4 Test description

6.4D.2.5.4.1 Initial condition

Same initial conditions as in clause 6.4D.2.4.4.1 with following exceptions:

- Instead of Table 6.4D.2.4.4.1-1 → use Table 6.4D.2.5.4.1-1

**Table 6.4D.2.5.4.1-1: Test Configuration**

Initial Conditions	
Test Environment as specified in TS 38.508-1 [10] subclause 4.1	Normal
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1	Low range, Mid range, High range
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1	Lowest, Mid, Highest
Test SCS as specified in TS 38.508-1 [10] subclause 5.3.5-1	Lowest
Test Parameters	

Test ID	Downlink Configuration	Uplink Configuration	
		Modulation	RB allocation (NOTE 1)
1	-	DFT-s-OFDM pi/2-BPSK	Outer_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.			
NOTE 2: Test Channel Bandwidths are checked separately for each NR band, which applicable channel bandwidths are specified in Table 5.3.5-1.			

#### 6.4D.2.5.4.2 Test procedure

1. Retrieve the LO position from the parameter txDirectCurrentLocation in UplinkTxDirectCurrent IE.
2. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.4D.2.5.4.1-1. Since the UE has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC.
3. Set the UE in the Inband Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
4. Send continuously uplink power control "up" commands in the uplink scheduling information to the UE until the UE transmits at P<sub>UMAX</sub> level. Allow at least 200 ms for the UE to reach P<sub>UMAX</sub> level. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
5. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition TxRx.
6. Measure spectrum flatness using Global In-Channel Tx-Test (Annex E) for the  $\theta$ - and  $\phi$ -polarizations, respectively. For TDD, only slots consisting of only UL symbols are under test.
7. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

#### 6.4D.2.5.4.3 Message contents

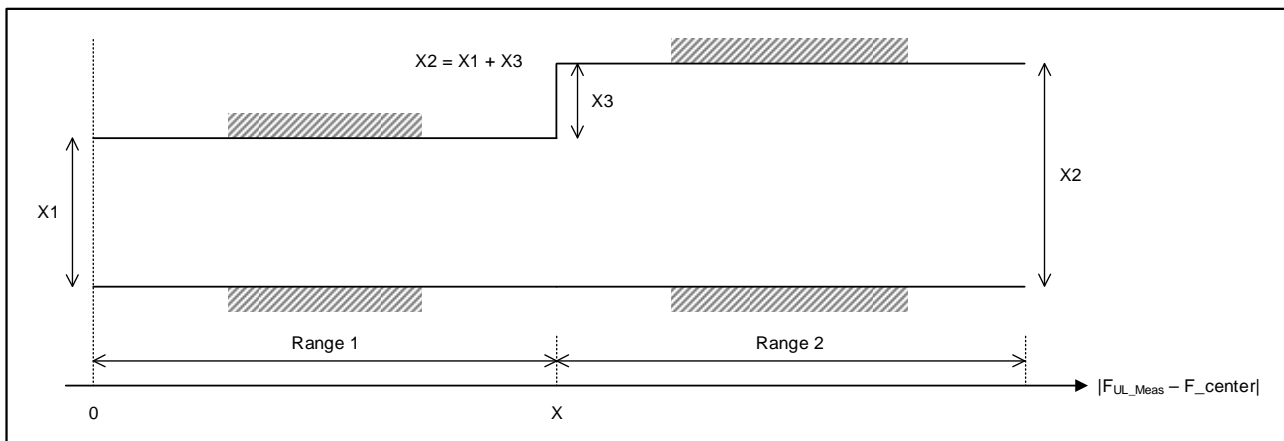
Message contents are according to TS 38.508-1 [10] subclause 4.6 with TRANSFORM\_PRECODER\_ENABLED condition in Table 4.6.3-118 PUSCH-Config and ensuring Table 4.6.3-182 with condition 2TX\_UL\_MIMO.

#### 6.4D.2.5.5 Test requirement

Each of the  $n$  spectrum flatness functions, shall derive four ripple results in Annex E.4.4. The derived results shall not exceed the values in Table 6.4D.2.5.5-1 and Figure 6.4D.2.5.5-1:

**Table 6.4D.2.5.5-1: Test requirement for EVM equalizer coefficients for pi/2 BPSK (normal conditions)**

Frequency range	Parameter	Maximum ripple (dB)
$ F_{UL\_Meas} - F_{center}  \leq X$ MHz (Range 1)	X1	6 + TT (p-p)
$ F_{UL\_Meas} - F_{center}  > X$ MHz (Range 2)	X2	14 + TT (p-p)
NOTE 1: $F_{UL\_Meas}$ refers to the sub-carrier frequency for which the equalizer coefficient is evaluated.		
NOTE 2: $F_{center}$ refers to the centre frequency of an allocated block of PRBs.		
NOTE 3: X, in MHz, is equal to 25% of the bandwidth of the PRB allocation.		
NOTE 4: See Figure 6.4D.2.5.5-1 for description of X1, X2 and X3.		



**Figure 6.4D.2.5.5-1: The limits for EVM equalizer spectral flatness with the maximum allowed variation.  $F_{\text{center}}$  denotes the centre frequency of the allocated block of PRBs**

The UE passes the test when the derived results for at least one polarization fulfil the test requirements.

### 6.4D.3 Time alignment error for UL MIMO

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- OTA test procedure for UL MIMO is still under investigation.
- Test tolerance is FFS

#### 6.4D.3.1 Test purpose

To verify that the error of time alignment in UL MIMO does not exceed the range prescribed by the specified UL MIMO Time Alignment Error (TAE) and tolerance.

An excess time alignment error has the possibility to interfere to other channels or other systems and decrease UL MIMO performance because of the timing unsynchronization.

#### 6.4D.3.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that support UL MIMO.

#### 6.4D.3.3 Minimum conformance requirements

For UE(s) with multiple physical antenna ports supporting UL MIMO, this requirement applies to frame timing differences between transmissions on multiple physical antenna ports in the codebook transmission scheme.

The time alignment error (TAE) is defined as the average frame timing difference between any two transmissions on different physical antenna ports.

For UE(s) with multiple physical antenna ports, the Time Alignment Error (TAE) shall not exceed 130 ns.

The normative reference for this requirement is TS 38.101-2 [3] clause 6.4D.3.

#### 6.4D.3.4 Test description

##### 6.4D.3.4.1 Initial condition

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, test channel bandwidths and sub-carrier spacing based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each combination of test channel bandwidth and sub-carrier spacing, are shown in Table 6.4D.3.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.4D.3.4.1-1: Test Configuration Table**

Initial Conditions			
Test Environment as specified in TS 38.508-1 [10] subclause 4.1		Normal	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1		Mid range	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1		Lowest, Mid, Highest	
Test SCS as specified in Table 5.3.5-1.		Lowest, Highest	
Test Parameters			
Test ID	Downlink Configuration	Uplink Configuration	
		Modulation	RB allocation (NOTE 1)
1	-	CP-OFDM QPSK	Outer_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.			

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement Channels are set according to Table 6.4D.3.4.1-1.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.4D.3.4.3.

#### 6.4D.3.4.2 Test procedure

1. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.4D.3.4.1-1. Since the UE has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC. The PDCCH DCI format 0\_1 is specified with the condition 2TX\_UL\_MIMO in 38.508-1 [10] subclause 4.3.6.1.1.2.
2. Set the UE in the Inband Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
3. Send continuously uplink power control "up" commands in every uplink scheduling information to the UE until the UE transmits at P<sub>UMAX</sub> level. Allow at least 200ms starting from the first TPC Command for the UE to reach P<sub>UMAX</sub> level. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
4. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition TxRx.
5. Measure the timing of one sub-frame at each physical antenna port.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.



## 6.4D.3.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 ensuring Table 4.6.3-182 with condition 2TX\_UL\_MIMO.

## 6.4D.3.5 Test requirement

For UE(s) with multiple physical antenna ports, the Time Alignment Error (TAE) shall not exceed  $130 + TT$  ns.

**Table 6.4D.3.5-1: Test Tolerance (Time alignment error for UL MIMO)**

<b>Test Tolerance</b>
FFS

## 6.5 Output RF spectrum emissions

Unwanted emissions are divided into "Out-of-band emission" and "Spurious emissions" in 3GPP RF specifications. This notation is in line with ITU-R recommendations such as SM.329 [7] and the Radio Regulations [TBD].

ITU defines:

Out-of-band emission = Emission on a frequency or frequencies immediately outside the necessary bandwidth which results from the modulation process, but excluding spurious emissions.

Spurious emission = Emission on a frequency, or frequencies, which are outside the necessary bandwidth and the level of which may be reduced without affecting the corresponding transmission of information. Spurious emissions include harmonic emissions, parasitic emissions, intermodulation products and frequency conversion products but exclude out-of-band emissions.

Unwanted emissions = Consist of spurious emissions and out-of-band emissions.

The UE transmitter spectrum emission consists of the three components; the occupied bandwidth (channel bandwidth), the Out Of Band (OOB) emissions and the far out spurious emission domain.

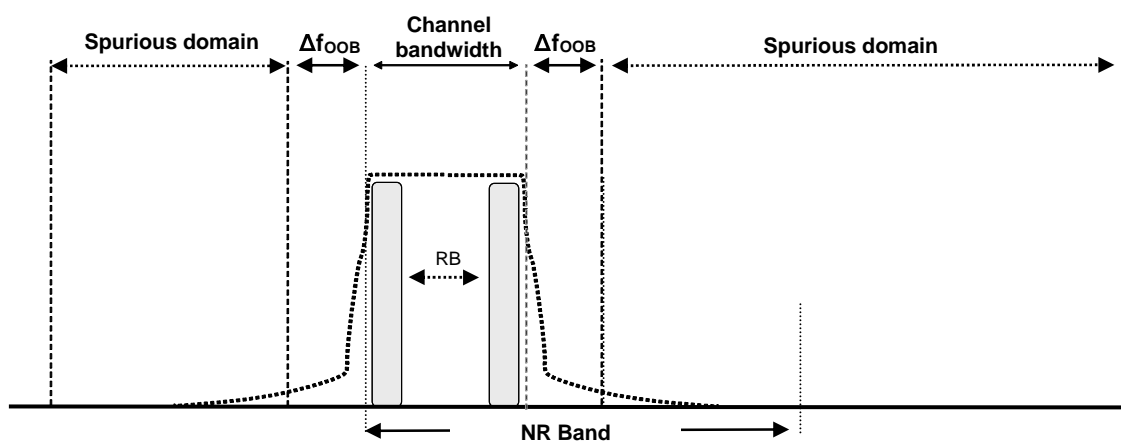


Figure 6.5-1: Transmitter RF spectrum

### 6.5.1 Occupied bandwidth

**Editor's note:** The following aspects are either missing or not yet determined:

- Measurement Uncertainty is FFS for n259.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2, and 4.

#### 6.5.1.1 Test purpose

To verify that the UE occupied bandwidth for all transmission bandwidth configurations supported by the UE are less than their specific limits

#### 6.5.1.2 Test applicability

This test applies to all types of NR UE release 15 and forward.

#### 6.5.1.3 Minimum conformance requirements

Occupied bandwidth is defined as the bandwidth containing 99 % of the total integrated mean power of the transmitted spectrum on the assigned channel. The occupied bandwidth for all transmission bandwidth configurations (Resources Blocks) shall be less than the channel bandwidth specified in Table 6.5.1.3-1.

The occupied bandwidth is defined as a directional requirement. The requirement is verified in beam locked mode with the test metric of OBW (Link=TX beam peak direction, Meas=Link angle).

**Table 6.5.1.3-1: Occupied channel bandwidth**

	Occupied channel bandwidth / Channel bandwidth			
	50 MHz	100 MHz	200 MHz	400 MHz
Channel bandwidth (MHz)	50	100	200	400

The normative reference for this requirement is TS 38.101-2 [3] clause 6.5.1.

#### 6.5.1.4 Test description

##### 6.5.1.4.1 Initial conditions

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, and channel bandwidths based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each channel bandwidth and subcarrier spacing, are shown in Table 6.5.1.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.5.1.4.1-1: Test Configuration Table**

Initial Conditions			
Test Environment as specified in TS 38.508-1 [10] clause 4.1		Normal	
Test Frequencies as specified in TS 38.508-1 [10] clause 4.3.1		Low range, Mid range, High range	
Test Channel Bandwidths as specified in TS 38.508-1 [10] clause 4.3.1		All	
Test SCS as specified in Table 5.3.5-1		Lowest	
Test Parameters			
Test ID	Downlink Configuration	Uplink Configuration	
		Modulation	RB allocation (NOTE 1)
1	-	DFT-s-OFDM QPSK	Outer_full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.			

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and clause A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] clause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement channels are set according to Table 6.5.1.4.1-1.
5. Propagation conditions are set according to Annex B.0
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.5.1.4.3

#### 6.5.1.4.2 Test procedure

1. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.5.1.4.1-1. Since the UL has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC.
2. Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (Note 1) for the UE Tx beam selection to complete.
3. Send continuously uplink power control "up" commands in every uplink scheduling information to the UE; allow at least 200 ms for the UE to reach maximum output power. Allow at least BEAM\_SELECT\_WAIT\_TIME (Note 1) for the UE Tx beam selection to complete.
4. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
5. Measure the EIRP spectrum distribution within 1.5-times or more frequency range over the requirement for Occupied Bandwidth specification centring on the current carrier frequency. The characteristics of the filter shall be approximately Gaussian (typical spectrum analyser filter). The measuring duration is one active uplink subframe. EIRP is captured from both polarizations, theta and phi.
6. Calculate the total EIRP from both polarizations, theta and phi, within the range of all frequencies measured in step 5 and save this value as "Total EIRP". EIRP measurement procedure is defined in Annex K.
7. Identify the measurement window whose centre is aligned on the centre of the channel for which the sum of the power measured in theta and phi polarization is 99% of the "Total EIRP".
8. The "Occupied Bandwidth" is the width of the measurement window obtained in step 7.

#### 6.5.1.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with TRANSFORM\_PRECODER\_ENABLED condition in Table 4.6.3-118 PUSCH-Config.

#### 6.5.1.5 Test requirement

The measured Occupied Bandwidth shall not exceed values in Table 6.5.1.5-1.

**Table 6.5.1.5-1: Occupied channel bandwidth**

	Occupied channel bandwidth / Channel bandwidth			
	50 MHz	100 MHz	200 MHz	400 MHz
<b>Channel bandwidth (MHz)</b>	50 + R	100 + R	200 + R	400 + R
NOTE 1: R is relaxation : R for each frequency and channel bandwidth is specified in Table 6.5.1.5-2.				

**Table 6.5.1.5-2: Relaxation due to testability limit (Occupied channel bandwidth)**

	Occupied channel bandwidth / Channel bandwidth			
	50 MHz	100 MHz	200 MHz	400 MHz
<b>n257, n258, n261</b>	0	0	0	0
<b>n260</b>	0	0	0	0
<b>n259</b>	TBD	TBD	TBD	TBD

## 6.5.2 Out of band emission

The Out of band emissions are unwanted emissions immediately outside the assigned channel bandwidth resulting from the modulation process and non-linearity in the transmitter but excluding spurious emissions. This out of band emission

limit is specified in terms of a spectrum emission mask and an Adjacent Channel Leakage power Ratio. Additional requirements to protect specific bands are also considered.

The requirements in clause 6.5.2.1 only apply when both UL and DL of a UE are configured for single CC operation, and they are of the same bandwidth. For a UE that is configured for single CC operation with different channel bandwidths in UL and DL, the requirements in clause 6.5A.2.1 apply.

All out of band emissions for range 2 are TRP.

## 6.5.2.1 Spectrum Emission Mask

**Editor's note: The following aspects are either missing or not yet determined:**

- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2, and 4.

### 6.5.2.1.1 Test purpose

To verify that the power of any UE emission shall not exceed specified level for the specified channel bandwidth.

### 6.5.2.1.2 Test applicability

This test case applies to all types of NR UE release 15 and forward.

### 6.5.2.1.3 Minimum conformance requirements

The spectrum emission mask of the UE applies to frequencies ( $\Delta f_{\text{OOB}}$ ) starting from the  $\pm$  edge of the assigned NR channel bandwidth. For frequencies offset greater than  $F_{\text{OOB}}$  as specified in Table 6.5.2.1.3-1 the spurious requirements in clause 6.5.3 are applicable.

The power of any UE emission shall not exceed the levels specified in Table 6.5.2.1.3-1 for the specified channel bandwidth. The requirement is verified in beam locked mode with the test metric of TRP (Link=TX beam peak direction, Meas=TRP grid).

**Table 6.5.2.1.3-1: General NR spectrum emission mask for Range 2.**

Spectrum emission limit (dBm)/ Channel bandwidth					
$\Delta f_{\text{OOB}}$ (MHz)	50 MHz	100 MHz	200 MHz	400 MHz	Measurement bandwidth
$\pm 0-5$	-5	-5	-5	-5	1 MHz
$\pm 5-10$	-13	-5	-5	-5	1 MHz
$\pm 10-20$	-13	-13	-5	-5	1 MHz
$\pm 20-40$	-13	-13	-13	-5	1 MHz
$\pm 40-100$	-13	-13	-13	-13	1 MHz
$\pm 100-200$		-13	-13	-13	1 MHz
$\pm 200-400$			-13	-13	1 MHz
$\pm 400-800$				-13	1 MHz

The normative reference for this requirement is TS 38.101-2 [3] clause 6.5.2.1.

### 6.5.2.1.4 Test description

#### 6.5.2.1.4.1 Initial conditions

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, and channel bandwidths based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each channel bandwidth and subcarrier spacing, are shown in Table 6.5.2.1.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

Table 6.5.2.1.4.1-1: Test Configuration Table

Initial Conditions			
Test Environment as specified in TS 38.508-1 [10] subclause 4.1		Normal	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1		Mid range	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1		Lowest, Highest	
Test SCS as specified in Table 5.3.5-1		Highest	
Test Parameters			
Test ID	Downlink Configuration	Uplink Configuration	
		Modulation	RB allocation (NOTE 1)
1	-	DFT-s-OFDM PI/2 BPSK	Outer_Full
2	-	DFT-s-OFDM QPSK	Outer_Full
3	-	DFT-s-OFDM 16 QAM	Outer_Full
4	-	DFT-s-OFDM 64 QAM	Outer_Full
5	-	CP-OFDM QPSK	Outer_Full
NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.			
NOTE 2: All test points in this table must also exist in Table 6.2.2.4.1-1, Table 6.2.2.4.1-2, Table 6.2.2.4.1-3 (MPR) for PC1 or Table 6.2.2.4.1-7, Table 6.2.2.4.1-8, Table 6.2.2.4.1-9 (MPR) for PC2, PC3 and PC4.			

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and clause A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement channels are set according to Table 6.5.2.1.4.1-1.
5. Propagation conditions are set according to Annex B.0
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.5.2.1.4.3

#### 6.5.2.1.4.2 Test procedure

1. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.5.2.1.4.1-1. Since the UL has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC.
2. Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 2) for the UE Tx beam selection to complete.
3. Send continuously uplink power control "up" commands in every uplink scheduling information to the UE; allow at least 200 ms for the UE to reach maximum output power. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 2) for the UE Tx beam selection to complete.
4. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
5. Measure the TRP of the transmitted signal with a measurement filter of bandwidths according to Table 6.5.2.1.5-1. The centre frequency of the filter shall be stepped in continuous steps according to the same table. TRP shall be recorded for each step. The measurement period shall capture the active time slots. Total radiated power is measured according to TRP measurement procedure defined in Annex K. The measurement grid used for TRP measurement defined in Annex M. TRP is calculated considering both polarizations, theta and phi.

NOTE 1: When switching to DFT-s-OFDM waveform, as specified in Table 6.5.2.1.4.1-1, send an NR RRCReconfiguration message according to TS 38.508-1 [10] clause 4.6.3 Table 4.6.3-118 PUSCH-Config with TRANSFORM\_PRECODER\_ENABLED condition.

NOTE 2: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

#### 6.5.2.1.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6.

#### 6.5.2.1.5 Test requirement

The measured TRP of any UE emission derived in step 5, shall fulfil requirements in Table.6.5.2.1.5-1.

**Table 6.5.2.1.5-1: General NR spectrum emission mask for Range 2**

Spectrum emission limit (dBm)/ Channel bandwidth					
$\Delta f_{\text{OBS}}$ (MHz)	50 MHz	100 MHz	200 MHz	400 MHz	Measurement bandwidth
$\pm 0-5$	-5 + TT	-5 + TT	-5 + TT	-5 + TT	1 MHz
$\pm 5-10$	-13 + TT	-5 + TT	-5 + TT	-5 + TT	1 MHz
$\pm 10-20$	-13 + TT	-13 + TT	-5 + TT	-5 + TT	1 MHz
$\pm 20-40$	-13 + TT	-13 + TT	-13 + TT	-5 + TT	1 MHz
$\pm 40-100$	-13 + TT	-13 + TT	-13 + TT	-13 + TT	1 MHz
$\pm 100-200$		-13 + TT	-13 + TT	-13 + TT	1 MHz
$\pm 200-400$			-13 + TT	-13 +TT	1 MHz
$\pm 400-800$				-13 + TT	1 MHz
NOTE 1: TT for each frequency and channel bandwidth is specified in Table 6.5.2.1.5-1a					
NOTE 2: At the boundary of spectrum emission limit, the first and last measurement position with a 1 MHz filter is the inside of +0.5MHz and -0.5MHz, respectively.					
NOTE 3: The measurements are to be performed above the upper edge of the channel and below the lower edge of the channel.					

**Table 6.5.2.1.5-1a: Test Tolerance (Spectrum emission mask)**

Test Metric	$23.45\text{GHz} \leq f \leq 32.125\text{GHz}$	$32.125\text{GHz} < f \leq 40.8\text{GHz}$
IFF (Max device size $\leq 30$ cm)	3.21 dB	3.46 dB

NOTE: As a general rule, the resolution bandwidth of the measuring equipment should be equal to the measurement bandwidth. However, to improve measurement accuracy, sensitivity and efficiency, the resolution bandwidth may be smaller than the measurement bandwidth. When the resolution bandwidth is smaller than the measurement bandwidth, the result should be integrated over the measurement bandwidth in order to obtain the equivalent noise bandwidth of the measurement bandwidth.

#### 6.5.2.2 Void

#### 6.5.2.3 Adjacent channel leakage ratio

Editor's note: The following aspects are either missing or not yet determined:

- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2, and 4.
- Testability for power class 1, 2 and 4 are FFS.

#### 6.5.2.3.1 Test purpose

To verify that UE transmitter does not cause unacceptable interference to adjacent channels in terms of Adjacent Channel Leakage power Ratio (ACLR).

#### 6.5.2.3.2 Test applicability

This test case applies to all types of NR UE release 15 and forward.

#### 6.5.2.3.3 Minimum conformance requirements

Adjacent Channel Leakage power Ratio (ACLR) is the ratio of the filtered mean power centred on the assigned channel frequency to the filtered mean power centred on an adjacent channel frequency. ACLR requirement is specified for a scenario in which adjacent carrier is another NR channel.

NR Adjacent Channel Leakage power Ratio ( $NR_{ACLR}$ ) is the ratio of the filtered mean power centred on the assigned channel frequency to the filtered mean power centred on an adjacent channel frequency at nominal channel spacing. The assigned NR channel power and adjacent NR channel power are measured with rectangular filters with measurement bandwidths specified in Table 6.5.2.3.3-1.

If the measured adjacent channel power is greater than  $-35$  dBm then the  $NR_{ACLR}$  shall be higher than the value specified in Table 6.5.2.3.3-1. The requirement is verified in beam locked mode with the test metric of TRP (Link=TX beam peak direction, Meas=TRP grid).

**Table 6.5.2.3.3-1: General requirements for  $NR_{ACLR}$**

	Channel bandwidth / $NR_{ACLR}$ / Measurement bandwidth			
	50 MHz	100 MHz	200 MHz	400 MHz
<b><math>NR_{ACLR}</math> for band n257, n258, n261</b>	17 dB	17 dB	17 dB	17 dB
<b><math>NR_{ACLR}</math> for band n260</b>	16 dB	16 dB	16 dB	16 dB
<b>NR channel Measurement bandwidth (MHz)</b>	47.58	95.16	190.20	380.28
<b>Adjacent channel centre frequency offset [MHz]</b>	+50 / -50	+100 / -100	+200 / -200	+400 / -400

The normative reference for this requirement is TS 38.101-2 [3] clause 6.5.2.3.

#### 6.5.2.3.4 Test description

##### 6.5.2.3.4.1 Initial conditions

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, and channel bandwidths based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each channel bandwidth and subcarrier spacing, are shown in Table 6.5.2.3.4.1-1 and Table 6.5.2.3.4.1-2. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.



**Table 6.5.2.3.4.1-1: Test Configuration Table (Power Class 1)**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal, TL, TH		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1				Low range, Mid range, High range		
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1				Lowest, Highest		
Test SCS as specified in Table 5.3.5-1				Lowest, Highest		
Test Parameters						
Test ID	Freq	ChBw	SCS	Downlink Configuration	Uplink Configuration	
		Default	Default	-	Modulation	RB allocation (NOTE 1)
1	Low				DFT-s-OFDM PI/2 BPSK	8@0
2	High				DFT-s-OFDM PI/2 BPSK	8@N <sub>RB</sub> -8
3	Mid				DFT-s-OFDM PI/2 BPSK	Outer_Full
4	Low				DFT-s-OFDM QPSK	8@0
5	High				DFT-s-OFDM QPSK	8@N <sub>RB</sub> -8
6	Mid				DFT-s-OFDM QPSK	Outer_Full
7	Low				DFT-s-OFDM 16 QAM	8@0
8	High				DFT-s-OFDM 16 QAM	8@N <sub>RB</sub> -8
9	Mid				DFT-s-OFDM 16 QAM	Outer_Full
10	Low				DFT-s-OFDM 64 QAM	8@0
11	High				DFT-s-OFDM 64 QAM	8@N <sub>RB</sub> -8
12	Mid				DFT-s-OFDM 64 QAM	Outer_Full
13	Low				CP-OFDM QPSK	8@0
14	High				CP-OFDM QPSK	8@N <sub>RB</sub> -8
15	Mid	CP-OFDM QPSK	Outer_Full			
NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-2 for PC1.						
NOTE 2: Following Test IDs shall be skipped for FR2b - FFS						
NOTE 3: All test points in this table must also exist in Table 6.2.2.4.1-1, Table 6.2.2.4.1-2, Table 6.2.2.4.1-3 (MPR).						

**Table 6.5.2.3.4.1-2: Test Configuration Table (Power Class 2, 3 and 4)**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal, TL, TH		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1				Low range, Mid range, High range		
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1				Lowest, Highest		
Test SCS as specified in Table 5.3.5-1				Lowest, Highest		
Test Parameters						
Test ID	Freq	ChBw	SCS	Downlink Configuration	Uplink Configuration	
		Default	Default	-	Modulation	RB allocation (NOTE 1)
1	Low				DFT-s-OFDM PI/2 BPSK	Outer_1RB_Left
2	High				DFT-s-OFDM PI/2 BPSK	Outer_1RB_Right
3	Mid				DFT-s-OFDM PI/2 BPSK	Outer_Full
4	Low				DFT-s-OFDM QPSK	Outer_1RB_Left
5	High				DFT-s-OFDM QPSK	Outer_1RB_Right
6	Mid				DFT-s-OFDM QPSK	Outer_Full
7	Low	DFT-s-OFDM 16 QAM	Outer_1RB_Left			

8	High			DFT-s-OFDM 16 QAM	Outer_1RB_Right
9	Mid			DFT-s-OFDM 16 QAM	Outer_Full
10	Low			DFT-s-OFDM 64 QAM	Outer_1RB_Left
11	High			DFT-s-OFDM 64 QAM	Outer_1RB_Right
12	Mid			DFT-s-OFDM 64 QAM	Outer_Full
13	Low			CP-OFDM QPSK	Outer_1RB_Left
14	High			CP-OFDM QPSK	Outer_1RB_Right
15	Mid			CP-OFDM QPSK	Outer_Full
<p>NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-1 for PC2, PC3 and PC4.</p> <p>NOTE 2: Following Test IDs shall be skipped for FR2b and PC3</p> <ul style="list-style-type: none"> <li>- All Test IDs for FR2b 400MHz Channel Bandwidth</li> <li>- Test ID 10-15 for FR2b 200MHz Channel Bandwidth</li> <li>- Test ID 10-12 for FR2b 100MHz Channel Bandwidth</li> </ul> <p>NOTE 3: All test points in this table must also exist in Table 6.2.2.4.1-7, Table 6.2.2.4.1-8, Table 6.2.2.4.1-9 (MPR).</p>					

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and section A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement channels are set according to Table 6.5.2.3.4.1-1 and Table 6.5.2.3.4.1-2.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity NR, Connected without release On, Test Mode On and Test Loop Function On according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.5.2.3.4.3

#### 6.5.2.3.4.2 Test procedure

1. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.5.2.3.4.1-1 and Table 6.5.2.3.4.1-2. Since the UL has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC.
2. Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 2) for the UE Tx beam selection to complete.
3. Send continuously uplink power control "up" commands in every uplink scheduling information to the UE; allow at least 200 ms for the UE to reach maximum output power. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 2) for the UE Tx beam selection to complete.
4. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
5. Measure EIRP of the transmitted signal in the Tx beam peak direction for the assigned NR channel with a rectangular measurement filter with bandwidths according to Table 6.5.2.3.5-1. EIRP measurement procedure defined in Annex K. EIRP is calculated considering both polarizations, theta and phi.
6. Measure EIRP of the first NR adjacent channel on both lower and upper side of the assigned NR channel, respectively using a rectangular measurement filter with bandwidths according to Table 6.5.2.3.5-1. EIRP measurement procedure defined in Annex K. EIRP is calculated considering both polarizations, theta and phi.
7. Calculate the ratios of the power between the values measured in step 5 over step 6 for lower and upper NR ACLR, respectively.

NOTE 1: When switching to DFT-s-OFDM waveform, as specified in the Table 6.5.2.3.4.1-1 and Table 6.5.2.3.4.1-2, send an NR RRCReconfiguration message according to TS 38.508-1 [10] clause 4.6.3 Table 4.6.3-118 PUSCH-Config with TRANSFORM\_PRECODER\_ENABLED condition.

NOTE 2: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

#### 6.5.2.3.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6.

#### 6.5.2.3.5 Test requirement

The measured NR ACLR, derived in step 7, shall be higher than the limits in Table 6.5.2.3.5-1.

**Table 6.5.2.3.5-1: General requirements for NR<sub>ACLR</sub>**

	Channel bandwidth / NR <sub>ACLR</sub> / Measurement bandwidth			
	50 MHz	100 MHz	200 MHz	400 MHz
NR <sub>ACLR</sub> for band n257, n258, n261	17 - TT - R dB	17 - TT - R dB	17 - TT - R dB	17 - TT - R dB
NR <sub>ACLR</sub> for band n260	16 - TT dB	16 - TT dB	16 - TT dB	16 - TT dB
NR channel Measurement bandwidth (MHz)	47.58	95.16	190.20	380.28
Adjacent channel centre frequency offset [MHz]	+50 / -50	+100 / -100	+200 / -200	+400 / -400
NOTE 1: TT for each frequency and channel bandwidth is specified in Table 6.5.2.3.5-1a				
NOTE 2: R for each frequency, channel bandwidth and test point is specified in Table 6.5.2.3.5-1b				

**Table 6.5.2.3.5-1a: Test Tolerance (Adjacent channel leakage ratio)**

	Test ID	Channel bandwidth / NR <sub>ACLR</sub> / Measurement bandwidth			
		50 MHz	100 MHz	200 MHz	400 MHz
NR <sub>ACLR</sub> for band n257, n258, n261	1-2, 4-5	4.10	4.49	4.66	5.06
	3, 6	4.08	4.45	4.59	5.06
	7-9	4.15	4.59	4.85	3.34
	10-12	4.36	4.98	4.06	1.46
	13-15	4.17	4.62	4.91	2.99
NR <sub>ACLR</sub> for band n260	1-2, 4-5	4.48	4.65	4.97	-
	3, 6	4.45	4.58	4.84	-
	7-9	4.58	4.84	5.31	-
	10-12	4.97	-	-	-
	13-15	4.62	4.90	-	-

**Table 6.5.2.3.5-1b: Relaxation due to testability limit (Adjacent channel leakage ratio)**

	Test ID	Channel bandwidth / NR <sub>ACLR</sub> / Measurement bandwidth			
		50 MHz	100 MHz	200 MHz	400 MHz
NR <sub>ACLR</sub> for band n257, n258, n261	1-6	0	0	0	0
	7	0	0	0	2.5
	8	0	0	0	2.5
	9	0	0	0	2.5

10	0	0	1.5	5.5
11	0	0	1.5	5.5
12	0	0	1.5	5.5
13	0	0	0	3
14	0	0	0	3
15	0	0	0	3

NOTE 1: Relaxation value is derived by Table 6.5.2.3.5-1c for FR2a.  
NOTE 2: Relaxation value is 0 for FR2b.

**Table 6.5.2.3.5-1c: Relaxation value for FR2a ACLR**

MPR	CA bandwidth class		
	100 MHz	200 MHz	400 MHz
0	0	0	0
0.5	0	0	0
1	0	0	0
1.5	0	0	0
2	0	0	0
2.5	0	0	0
3	0	0	0
3.5	0	0	0.5
4	0	0	1
4.5	0	0	2.5
5	0	0	3
5.5	0	1.5	4.5
6	0	2	5
6.5	0	2.5	5.5
7	0	3	6
7.5	0.5	3.5	6.5
8	1	4	7
8.5	1.5	4.5	7.5
9	2	5	8

### 6.5.3 Spurious emissions

Spurious emissions are emissions which are caused by unwanted transmitter effects such as harmonics emission, parasitic emissions, intermodulation products and frequency conversion products, but exclude out of band emissions. The spurious emission limits are specified in terms of general requirements in line with SM.329 [7] and *NR* operating band requirement to address UE co-existence. Spurious emissions are measured as TRP.

To improve measurement accuracy, sensitivity and efficiency, the resolution bandwidth may be smaller than the measurement bandwidth. When the resolution bandwidth is smaller than the measurement bandwidth, the result should be integrated over the measurement bandwidth in order to obtain the equivalent noise bandwidth of the measurement bandwidth.

#### 6.5.3.1 Transmitter Spurious emissions

**Editor's Note:** This clause is complete for Band n257, n258, n260 and n261 and PC3. The following aspects of the clause are for future consideration:

- TRP Measurement uncertainty is TBD for above 80 GHz.
- Connection diagram between SS and UE in TS 38.508-1 [10] Annex A is FFS.
- Test procedure only includes the testing of smartphone and is FFS for laptop and FWA.

##### 6.5.3.1.1 Test purpose

To verify that UE transmitter does not cause unacceptable interference to other channels or other systems in terms of transmitter spurious emissions.

### 6.5.3.1.2 Test applicability

This test case applies to all types of NR UE release 15 and forward.

### 6.5.3.1.3 Minimum conformance requirements

Unless otherwise stated, the spurious emission limits apply for the frequency ranges that are more than  $F_{OOB}$  (MHz) in Table 6.5.3.1.3-1 starting from the edge of the assigned NR channel bandwidth. The spurious emission limits in Table 6.5.3.1.3-2 apply for all transmitter band configurations (NRB) and channel bandwidths. The requirement is verified in beam locked mode with the test metric of TRP (Link=TX beam peak direction, Meas=TRP grid).

NOTE: For measurement conditions at the edge of each frequency range, the lowest frequency of the measurement position in each frequency range should be set at the lowest boundary of the frequency range plus MBW/2. The highest frequency of the measurement position in each frequency range should be set at the highest boundary of the frequency range minus MBW/2. MBW denotes the measurement bandwidth defined for the protected band.

**Table 6.5.3.1.3-1: Boundary between NR out of band and spurious emission domain**

Channel bandwidth	50 MHz	100 MHz	200 MHz	400 MHz
OOB boundary $F_{OOB}$ (MHz)	100	200	400	800

The spurious emission limits in table 6.5.3.1.3-2 apply for all transmitter band configurations (RB) and channel bandwidths.

**Table 6.5.3.1.3-2: Spurious emissions limits**

Frequency Range	Maximum Level	Measurement bandwidth	NOTE
$30 \text{ MHz} \leq f < 1000 \text{ MHz}$	-36 dBm	100 kHz	
$1 \text{ GHz} \leq f < 12.75 \text{ GHz}$	-30 dBm	1 MHz	
$12.75 \text{ GHz} \leq f \leq 2^{\text{nd}}$ harmonic of the upper frequency edge of the UL operating band in GHz	-13 dBm	1 MHz	

The normative reference for this requirement is TS 38.101-2 subclause 6.5.3.

### 6.5.3.1.4 Test description

#### 6.5.3.1.4.1 Initial conditions

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, and channel bandwidths based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each channel bandwidth and subcarrier spacing, are shown in Table 6.5.3.1.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.5.3.1.4.1-1: Test Configuration Table**

Initial Conditions	
Test Environment as specified in TS 38.508-1 [10] subclause 4.1	Normal
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1	Low range, High range (NOTE 2)

Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1		Highest	
Test SCS as specified in Table 5.3.5-1		120kHz	
Test Parameters			
Test ID	Downlink Configuration	Uplink Configuration	
		Modulation	RB allocation (NOTE 1)
1	-	DFT-s -OFDM QPSK	Inner_Full for PC2, PC3 and PC4 Inner_Full_Region1 for PC1
2	-	DFT-s -OFDM QPSK	Inner_1RB for PC2, PC3 and PC4 Inner_Partial for PC1 (NOTE 3)
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.			
NOTE 2: When testing Low range test only in Frequency Range lower than $(F_{UL\_low} - \Delta f_{OOB})$ and when testing High range test only in Frequency Range higher than $(F_{UL\_high} + \Delta f_{OOB})$ .			
NOTE 3: When testing Low range configure uplink RB to Inner_1RB_Left for PC2, PC3 and PC4 or Inner_Partial_Left_Region1 for PC1 and when testing High range configure uplink RB to Inner_1RB_Right for PC2, PC3 and PC4 or Inner_Partial_Right_Region1 for PC1.			

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure [TBD] for TE diagram and Figure [TBD] for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement channels are set according to Table 6.5.3.1.4.1-1.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.5.3.1.4.3.

#### 6.5.3.1.4.2 Test procedure

1. Select any of the three Alignment Options (1, 2, or 3) from Tables N.2-1 through N.2-3 to mount the DUT inside the QZ.
2. If the re-positioning concept is applied, position the device in DUT Orientation 1 if the maximum beam peak direction is within zenith angular range  $0^\circ \leq \theta \leq 90^\circ$  for the alignment option selected in step 1; position the device in DUT Orientation 2 (either Options 1 or 2) if the maximum beam peak direction is within zenith angular range  $90^\circ < \theta \leq 180^\circ$  for DUT Orientation 1 for the alignment option selected in step 1. If the re-positioning concept is not applied, position the device in DUT Orientation 1.
3. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.5.3.1.4.1-1. Since the UL has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC.
4. Set the UE in the Inband Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 3) for the UE Tx beam selection to complete.
5. Send continuously uplink power control "up" commands in every uplink scheduling information to the UE; allow at least 200msec for the UE to reach  $P_{UMAX}$ . Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 3) for the UE Tx beam selection to complete.
6. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.

7. Measure the spurious emissions as per steps outlined below with an exception to the procedure in Annex K if the re-positioning concept is applied (NOTE 4). Step (a) is optional and applicable only if SNR (test requirement level in Table 6.5.3.1.5-1 minus offset value minus noise floor of the test system)  $\geq 0$  dB is guaranteed.

- (a) Perform coarse TRP measurements to identify spurious emission frequencies and corresponding power level according to the procedures in Annex K, using coarse TRP measurement grid selection criteria as per Table M.4.5-3 in Annex M. The measurement is completed in both polarizations  $\theta$  and  $\phi$  over frequency range and measurement bandwidth according to Table 6.5.3.1.5-1. Optionally, a larger and non-constant measurement bandwidth than that of Table 6.5.3.1.5-1 may be applied. The measurement period shall capture the active time slots. For each spurious emission frequency with coarse TRP identified to be less than an offset dB from the TRP limit according to Table 6.5.3.1.5-1, continue with fine TRP procedures according to step (b).

The offset value shall be the TRP measurement uncertainty at 95% confidence level including the effect of coarse grid measurement uncertainty element, excluding the influence of noise. Different coarse TRP grids and corresponding offset values may be used for different frequencies. The coarse TRP grid and offset values used shall be recorded in the test report.

**Table 6.5.3.1.4.2-1: Typical offset values for coarse TRP measurement step 7(a)**

Grid	Frequency Range	Offset Value
Constant Density	6 GHz $\leq$ f < 12.75 GHz	5.13
	12.75 GHz $\leq$ f < 23.45GHz	5.09
	23.45 GHz $\leq$ f < 40.8GHz	5.38
	40.8 GHz $\leq$ f < 66GHz	7.31
	66 GHz $\leq$ f $\leq$ 80GHz	7.61
Constant-Step Size	6 GHz $\leq$ f < 12.75 GHz	5.26
	12.75 GHz $\leq$ f < 23.45GHz	5.23
	23.45 GHz $\leq$ f < 40.8GHz	5.52
	40.8 GHz $\leq$ f < 66GHz	7.43
	66 GHz $\leq$ f $\leq$ 80GHz	7.73
NOTE 1: These offset values are the upper limit values when fine TRP measurement uncertainty of the test system is same as maximum test system uncertainty in Annex F and when using the coarse measurement grid with minimum number of points as specified in Table M.4.5-3.		
NOTE 2: It is allowed to use the offset values derived based on test system's actual measurement uncertainty budget and denser measurement grid as specified in Table M.4.5-3.		

- (b) Measure fine TRP measurements according to procedures in Annex K, using fine TRP measurement grid selection criteria as per Table M.4.5-3 in Annex M, for each of the spurious emission frequency identified in step (a). Apply a measurement bandwidth according to Table 6.5.3.1.5-1.

8. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

NOTE 1: The frequency range defined in Table 6.5.3.1.5-1 may be split into ranges. For each range a different test system, e.g. antenna and/or chamber, may be used. To pass the test case all verdicts of the frequency ranges must pass.

NOTE 2: Void.

NOTE 3: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

NOTE 4: If the (in-band) beam peak is within  $0^\circ \leq \theta < 90^\circ$ : perform first hemispherical TRP scan ( $0^\circ \leq \theta < 90^\circ$ ) in DUT Orientation 1 and second hemispherical TRP scan ( $90^\circ > \theta \geq 0^\circ$ ) in DUT Orientation 2. If the (in-band) beam peak is within  $90^\circ < \theta \leq 180^\circ$ : perform first hemispherical TRP scan ( $0^\circ \leq \theta < 90^\circ$ ) in DUT Orientation 2 and second hemispherical TRP scan ( $90^\circ > \theta \geq 0^\circ$ ) in DUT Orientation 1. The DUT with UBF activated needs to be re-positioned during the test.

NOTE 5: The coarse TRP measurement grid and corresponding offset dB value referred in step 7(a) above, for some valid grids can be found in TR 38.903[20] section B.18.

#### 6.5.3.1.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with TRANSFORM\_PRECODER\_ENABLED condition in Table 4.6.3-118 PUSCH-Config.

#### 6.5.3.1.5 Test requirement

This clause specifies the requirements for the specified *NR* band for Transmitter Spurious emissions requirement with frequency range as indicated in Table 6.5.3.1.5-1.

The maximum TRP power of spurious emission, measured using RMS detector, shall not exceed the described value in Table 6.5.3.1.5-1.

Unless otherwise stated, the spurious emission limits apply for the frequency ranges that are more than  $F_{OOB}$  (MHz) in Table 6.5.3.1.3-1 starting from the edge of the assigned *NR* channel bandwidth. The spurious emission limits in Table 6.5.3.1.5-1 apply for all transmitter band configurations (NRB) and channel bandwidths.

**NOTE:** For measurement conditions at the edge of each frequency range, the lowest frequency of the measurement position in each frequency range should be set at the lowest boundary of the frequency range plus  $MBW/2$ . The highest frequency of the measurement position in each frequency range should be set at the highest boundary of the frequency range minus  $MBW/2$ .  $MBW$  denotes the measurement bandwidth defined for the protected band.

**Table 6.5.3.1.5-1: Spurious emissions test requirements**

Frequency Range	Maximum Level	Measurement bandwidth	NOTE
$6 \text{ GHz} \leq f < 12.75 \text{ GHz}$	-30 dBm	1 MHz	
$12.75 \text{ GHz} \leq f \leq 2^{\text{nd}}$ harmonic of the upper frequency edge of the UL operating band in GHz	-13 dBm	1 MHz	
NOTE 1: Applies for Band n257, n258, n260, n261			

#### 6.5.3.2 Spurious emission band UE co-existence

**Editor's note:** This clause is complete for Band n257, n258, n260 and n261 and PC3. The following aspects of the clause are for future consideration:

- TRP Measurement uncertainty is TBD for PC1, PC2 and PC4.
- Connection diagram between SS and UE in TS 38.508-1 [10] Annex A is FFS.
- Test procedure only includes the testing of smartphone and is FFS for laptop and FWA.

##### 6.5.3.2.1 Test purpose

To verify that UE transmitter does not cause unacceptable interference when in co-existence with protected bands in terms of transmitter spurious emissions.

##### 6.5.3.2.2 Test applicability

This test case applies to all types of *NR* UE release 15 and forward.

##### 6.5.3.2.3 Minimum conformance requirements

This clause specifies the requirements for the specified *NR* band, for co-existence with protected bands. The requirement is verified in beam locked mode with the test metric of TRP (Link=TX beam peak direction, Meas=TRP grid).



NOTE: For measurement conditions at the edge of each frequency range, the lowest frequency of the measurement position in each frequency range should be set at the lowest boundary of the frequency range plus MBW/2. The highest frequency of the measurement position in each frequency range should be set at the highest boundary of the frequency range minus MBW/2. MBW denotes the measurement bandwidth defined for the protected band.

The spurious emission UE co-existence limits in Table 6.5.3.2.3-1 apply for all transmitter band configurations (RB) and channel bandwidths.

**Table 6.5.3.2.3-1: Spurious emissions UE co-existence limits**

NR Band	Spurious emission						
	Protected band/frequency range	Frequency range (MHz)		Maximum Level (dBm)	MBW (MHz)	NOTE	
n257	NR Band n260	F <sub>DL_low</sub>	-	F <sub>DL_high</sub>	-2	100	
	Frequency range	57000	-	66000	2	100	
	Frequency range	23600	-	24000	1	200	3
n258	Frequency range	57000	-	66000	2	100	
n259	NR Band 257	F <sub>DL_low</sub>	-	F <sub>DL_high</sub>	-5	100	n259
	NR Band 261	F <sub>DL_low</sub>	-	F <sub>DL_high</sub>	-5	100	
	Frequency range	36000	-	37000	7	1000	
	Frequency range	57000	-	66000	2	100	
n260	NR Band 257	F <sub>DL_low</sub>	-	F <sub>DL_high</sub>	-5	100	
	NR Band 261	F <sub>DL_low</sub>	-	F <sub>DL_high</sub>	-5	100	
	Frequency range	57000	-	66000	2	100	
n261	NR Band 260	F <sub>DL_low</sub>	-	F <sub>DL_high</sub>	-2	100	
	Frequency range	57000	-	66000	2	100	
NOTE 1: F <sub>DL_low</sub> and F <sub>DL_high</sub> refer to each NR frequency band specified in Table 5.2-1.							
NOTE 2: Void.							
NOTE 3: The protection of frequency range 23600-24000 MHz is meant for protection of satellite passive services.							

The normative reference for this requirement is TS 38.101-2 subclause 6.5.3.1.

6.5.3.2.4 Test description

6.5.3.2.4.1 Initial conditions

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, and channel bandwidths based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each channel bandwidth and subcarrier spacing, are shown in Table 6.5.3.2.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.5.3.2.4.1-1: Test Configuration Table**

Initial Conditions			
Test Environment as specified in TS 38.508-1 [10] subclause 4.1		Normal	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1		Low range, High range (NOTE 2)	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1		Highest	
Test SCS as specified in Table 5.3.5-1		120kHz	
Test Parameters			
Test ID	Downlink Configuration	Uplink Configuration	
1	-	Modulation	RB allocation (NOTE 1)
		DFT-s-OFDM QPSK	Inner_Full for PC2, PC3

			and PC4 Inner_Full_Region1 for PC1
2		DFT-s-OFDM QPSK	Inner_1RB for PC2, PC3 and PC4 Inner_Partial for PC1 (NOTE 3)
<p>NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.</p> <p>NOTE 2: When testing Low range test only in Frequency Range lower than <math>(F_{UL\_low} - \Delta f_{OOB})</math> and when testing High range test only in Frequency Range higher than <math>(F_{UL\_high} + \Delta f_{OOB})</math>.</p> <p>NOTE 3: When testing Low range configure uplink RB to Inner_1RB_Left for PC2, PC3 and PC4 or Inner_Partial_Left_Region1 for PC1 and when testing High range configure uplink RB to Inner_1RB_Right for PC2, PC3 and PC4 or Inner_Partial_Right_Region1 for PC1.</p>			

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure [TBD] for TE diagram and Figure [TBD] for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement channels are set according to Table 6.5.3.2.4.1-1
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.5.3.2.4.3.

#### 6.5.3.2.4.2 Test procedure

1. Select any of the three Alignment Options (1, 2, or 3) from Tables N.2-1 through N.2-3 to mount the DUT inside the QZ.
2. If the re-positioning concept is applied, position the device in DUT Orientation 1 if the maximum beam peak direction is within zenith angular range  $0^\circ \leq \theta \leq 90^\circ$  for the alignment option selected in step 1; position the device in DUT Orientation 2 (either Options 1 or 2) if the maximum beam peak direction is within zenith angular range  $90^\circ < \theta \leq 180^\circ$  for DUT Orientation 1 for the alignment option selected in step 1. If the re-positioning concept is not applied, position the device in DUT Orientation 1.
3. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.5.3.2.4.1-1. Since the UL has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC.
4. Set the UE in the Inband Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 3) for the UE Tx beam selection to complete.
5. Send continuously uplink power control "up" commands in every uplink scheduling information to the UE; allow at least 200msec for the UE to reach  $P_{UMAX}$ . Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 3) for the UE Tx beam selection to complete.
6. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
7. Measure the spurious emissions as per steps outlined below with an exception to the procedure in Annex K if the re-positioning concept is applied (NOTE 4):
  - (a) Perform coarse TRP measurements to identify spurious emission frequencies and corresponding power level according to the procedures in Annex K, using coarse TRP measurement grid selection criteria as per Table M.4.5-3 in Annex M. The measurement is completed in both polarizations  $\theta$  and  $\phi$  over frequency range and measurement bandwidth according to Table 6.5.3.2.3-1. Optionally, a larger and non-constant measurement bandwidth than that of Table 6.5.3.2.3-1 may be applied as long as the SNR (ratio of test limit to floor noise of test equipment)  $\geq 10$ dB is guaranteed. The measurement period shall capture the active time slots. For

each spurious emission frequency with coarse TRP identified to be less than an offset dB (NOTE 2) from the TRP limit according to Table 6.5.3.2.3-1, continue with fine TRP procedures according to step (b).

The offset value shall be the TRP measurement uncertainty at 95% confidence level including the effect of coarse grid measurement uncertainty element. Different coarse TRP grids and corresponding offset values may be used for different frequencies. The coarse TRP grid and offset values used shall be recorded in the test report.

- (b) Measure fine TRP measurements according to procedures in Annex K, using fine TRP measurement grid selection criteria as per Table M.4.5-3 in Annex M, for each of the spurious emission frequency identified in step (a). Apply a measurement bandwidth according to Table 6.5.3.2.3-1.

8. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

NOTE 1: The frequency range defined in Table 6.5.3.2.3-1 may be split into ranges. For each range a different test system, e.g. antenna and/or chamber, may be used. To pass the test case all verdicts of the frequency ranges must pass.

NOTE 2: The coarse TRP measurement grid and corresponding offset dB value referred in step 7(a) above, for some valid grids can be found in TR 38.903 section B.18.

NOTE 3: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

NOTE 4: If the (in-band) beam peak is within  $0^\circ \leq \theta \leq 90^\circ$ : perform first hemispherical TRP scan ( $0^\circ \leq \theta \leq 90^\circ$ ) in DUT Orientation 1 and second hemispherical TRP scan ( $90^\circ > \theta \geq 0^\circ$ ) in DUT Orientation 2. If the (in-band) beam peak is within  $90^\circ < \theta \leq 180^\circ$ : perform first hemispherical TRP scan ( $0^\circ \leq \theta \leq 90^\circ$ ) in DUT Orientation 2 and second hemispherical TRP scan ( $90^\circ > \theta \geq 0^\circ$ ) in DUT Orientation 1. The DUT with UBF activated needs to be re-positioned during the test.

#### 6.5.3.2.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with TRANSFORM\_PRECODER\_ENABLED condition in Table 4.6.3-118 PUSCH-Config.

#### 6.5.3.2.5 Test requirement

This clause specifies the requirements for the specified NR band for Transmitter Spurious emissions for UE co-existence requirement with frequency range as indicated in Table 6.5.3.2.5-1.

The maximum TRP power of spurious emission for UE co-existence, measured using RMS detector, shall not exceed the described value in Table 6.5.3.2.5-1.

The spurious emission UE co-existence limits in Table 6.5.3.2.5-1 apply for all transmitter band configurations (NRB) and channel bandwidths.

NOTE: For measurement conditions at the edge of each frequency range, the lowest frequency of the measurement position in each frequency range should be set at the lowest boundary of the frequency range plus MBW/2. The highest frequency of the measurement position in each frequency range should be set at the highest boundary of the frequency range minus MBW/2. MBW denotes the measurement bandwidth defined for the protected band.

**Table 6.5.3.2.5-1: Spurious emissions UE co-existence test requirements**

NR Band	Spurious emission						
	Protected band/frequency range	Frequency range (MHz)			Maximum Level (dBm)	MBW (MHz)	NOTE
n257	NR Band n260	F <sub>DL_low</sub>	-	F <sub>DL_high</sub>	-2 + 5.0	100	NOTE 3
	Frequency range	57000	-	66000	2	100	
	Frequency range	23600	-	24000	1 + 0.3	200	NOTE 6
n258	Frequency range	57000	-	66000	2	100	
n259	NR Band 257	F <sub>DL_low</sub>	-	F <sub>DL_high</sub>	-5 + 3.3	100	n259, NOTE 4

	NR Band 261	F <sub>DL_low</sub>	-	F <sub>DL_high</sub>	-5 + 3.3	100	NOTE 4
	Frequency range	36000	-	37000	7 + 6.0	1000	NOTE 5
	Frequency range	57000	-	66000	2	100	
n260	NR Band 257	F <sub>DL_low</sub>	-	F <sub>DL_high</sub>	-5 + 3.3	100	NOTE 4
	NR Band 261	F <sub>DL_low</sub>	-	F <sub>DL_high</sub>	-5 + 3.3	100	NOTE 4
	Frequency range	57000	-	66000	2	100	
n261	NR Band 260	F <sub>DL_low</sub>	-	F <sub>DL_high</sub>	-2 + 5.0	100	NOTE 3
	Frequency range	57000	-	66000	2	100	
NOTE 1: F <sub>DL_low</sub> and F <sub>DL_high</sub> refer to each NR frequency band specified in Table 5.2-1.							
NOTE 2: Void.							
NOTE 3: 5.0 dB relaxation due to testability limit							
NOTE 4: 3.3 dB relaxation due to testability limit							
NOTE 5: 6.0 dB relaxation due to testability limit							
NOTE 6: 0.3 dB relaxation due to testability limit							

### 6.5.3.3 Additional spurious emissions

**Editor's note:** This clause is complete for Band n257 and n258 and PC3. The following aspects of the clause are for future consideration:

- Connection diagram between SS and UE in TS 38.508-1 [10] Annex A is FFS.
- Test procedure only includes the testing of smartphone and is FFS for laptop and FWA.

#### 6.5.3.3.1 Test purpose

Additional spurious emission requirements are signalled by the network to indicate that the UE shall meet an additional requirement for a specific deployment scenario as part of the cell handover/broadcast message.

#### 6.5.3.3.2 Test applicability

This test case applies to all types of NR UE release 15 and forward.

#### 6.5.3.3.3 Minimum conformance requirements

The additional spurious emission limits in Table 6.5.3.3.3-2 through Table 6.5.3.3.3-3 apply for all transmitter band configurations (RB) and channel bandwidths. The requirement is verified in beam locked mode with the test metric of TRP (Link=TX beam peak direction, Meas=TRP grid).

NOTE: For measurement conditions at the edge of each frequency range, the lowest frequency of the measurement position in each frequency range should be set at the lowest boundary of the frequency range plus MBW/2. The highest frequency of the measurement position in each frequency range should be set at the highest boundary of the frequency range minus MBW/2. MBW denotes the measurement bandwidth defined for the protected band.

**Table 6.5.3.3.3-1: Void**

When "NS\_202" is indicated in the cell, the power of any UE emission shall not exceed the levels specified in Table 6.5.3.3.3-2.

**Table 6.5.3.3.3-2: Additional spurious emissions (NS\_202) test limits**

Frequency Range	Maximum Level	Measurement bandwidth
7.25 GHz ≤ f ≤ 2 <sup>nd</sup> harmonic of the upper frequency edge of the UL operating band	-10 dBm	100 MHz
23.6 GHz ≤ f ≤ 24.0 GHz	+1 dBm	200 MHz
NOTE 1: This requirement also applies for the frequency ranges that are less than F <sub>OOB</sub> (MHz) in Table 6.5.3.1.3-1 from the edge		

of the channel bandwidth. The protection of frequency range 23600 - 24000 MHz is meant for protection of satellite passive services.

When "NS\_203" is indicated in the cell, the power of any UE emission shall not exceed the levels specified in Table 6.5.3.3.3-3. This requirement also applies for the frequency ranges that are less than  $F_{OOB}$  (MHz) in Table 6.5.3.1.3-1 from the edge of the channel bandwidth.

**Table 6.5.3.3.3-3: Additional spurious emissions (NS\_203) test limits**

Frequency band (GHz)	Spectrum emission limit (dBm)	Measurement bandwidth
$23.6 \leq f \leq 24.0$	+1	200 MHz

The normative reference for this requirement is TS 38.101-2 subclause 6.5.3.2.

#### 6.5.3.3.4 Test description

##### 6.5.3.3.4.1 Initial conditions

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, and channel bandwidths based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each channel bandwidth and subcarrier spacing, are shown in Table 6.5.3.3.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.5.3.3.4.1-1: Test Configuration Table for NS\_202**

Initial Conditions			
Test Environment as specified in TS 38.508-1 [10] subclause 4.1		Normal	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1		Low range, High range (NOTE 2)	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1		Highest	
Test SCS as specified in Table 5.3.5-1		120kHz	
Test Parameters			
Test ID	Downlink Configuration	Uplink Configuration	
		Modulation	RB allocation (NOTE 1)
1 (NOTE 5)	-	DFT-s-OFDM QPSK	Inner_Full
2		DFT-s-OFDM QPSK	Inner_1RB_Left for PC2, PC3 and PC4 Inner_Partial for PC1 (NOTE 3)
3 (NOTE 4)		DFT-s-OFDM 64QAM	Outer_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.			
NOTE 2: When testing Low range test only in Frequency Range lower than $(F_{UL\_low} - \Delta f_{OOB})$ and when testing High range test only in Frequency Range higher than $(F_{UL\_high} + \Delta f_{OOB})$ .			
NOTE 3: When testing Low range configure uplink RB to Inner_1RB_Left for PC2, PC3 and PC4 or Inner_Partial_Left_Region1 for PC1 and when testing High range configure uplink RB to Inner_1RB_Right for PC2, PC3 and PC4 or Inner_Partial_Right_Region1 for PC1.			
NOTE 4: Test ID only applicable to PC1			
NOTE 5: Test ID not applicable to PC1.			

Table 6.5.3.3.4.1-2: Test Configuration Table for NS\_203

Initial Conditions					
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1			Low range		
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1			Highest		
Test SCS as specified in Table 5.3.5-1			120kHz		
Test Parameters					
Test ID	Frequency	Channel Bandwidth	Downlink Configuration	Uplink Configuration	
				Modulation	RB allocation (NOTE 1)
1	Default	Default	-	DFT-s-OFDM QPSK	Inner_Full
2	Default	Default		DFT-s-OFDM QPSK	Inner_1RB_Left for PC2, PC3 and PC4 Inner_Partial_Left_Region1 for PC1
3 (NOTE 2)	Low range + Channel Bandwidth (NOTE 3)	Default		DFT-s-OFDM QPSK	Inner_Partial_Left_Region1
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.					
NOTE 2: Test ID only applicable to PC1.					
NOTE 3: Test frequency for test ID 3 is specified in Table 6.2.3.4.1-4.					

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure [TBD] for TE diagram and Figure [TBD] for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement channels are set according to Table 6.5.3.3.4.1-1
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.5.3.3.4.3.

#### 6.5.3.3.4.2 Test procedure

1. Select any of the three Alignment Options (1, 2, or 3) from Tables N.2-1 through N.2-3 to mount the DUT inside the QZ.
2. If the re-positioning concept is applied, position the device in DUT Orientation 1 if the maximum beam peak direction is within zenith angular range  $0^\circ \leq \theta \leq 90^\circ$  for the alignment option selected in step 1; position the device in DUT Orientation 2 (either Options 1 or 2) if the maximum beam peak direction is within zenith angular range  $90^\circ < \theta \leq 180^\circ$  for DUT Orientation 1 for the alignment option selected in step 1. If the re-positioning concept is not applied, position the device in DUT Orientation 1.
3. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.5.3.3.4.1-1. Since the UL has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC.
4. Set the UE in the Inband Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 3) for the UE Tx beam selection to complete.

5. Send continuously uplink power control "up" commands in every uplink scheduling information to the UE; allow at least 200msec for the UE to reach  $P_{UMAX}$ . Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 3) for the UE Tx beam selection to complete.
6. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
7. Measure the spurious emissions as per steps outlined below with an exception to the procedure in Annex K if the re-positioning concept is applied (NOTE 4). Step (a) is optional and applicable only if SNR (test requirement level in Table 6.5.3.3.5-2 through Table 6.5.3.3.5-3, minus offset value minus noise floor of the test system)  $\geq 0$  dB is guaranteed.

- (a) Perform coarse TRP measurements to identify spurious emission frequencies and corresponding power level according to the procedures in Annex K, using coarse TRP measurement grid selection criteria as per Table M.4.5-3 in Annex M. The measurement is completed in both polarizations  $\theta$  and  $\phi$  over frequency range and measurement bandwidth according to Table 6.5.3.3.5-2 through Table 6.5.3.3.5-3. Optionally, a larger and non-constant measurement bandwidth than that of Table 6.5.3.3.5-2 through Table 6.5.3.3.5-3 may be applied. The measurement period shall capture the active time slots. For each spurious emission frequency with coarse TRP identified to be less than an offset dB from the TRP limit according to Table 6.5.3.3.5-2 through Table 6.5.3.3.5-3, continue with fine TRP procedures according to step (b).

The offset value shall be the TRP measurement uncertainty at 95% confidence level including the effect of coarse grid measurement uncertainty element. Different coarse TRP grids and corresponding offset values may be used for different frequencies. The coarse TRP grid and offset values used shall be recorded in the test report.

- (b) Measure fine TRP measurements according to procedures in Annex K, using fine TRP measurement grid selection criteria as per Table M.4.5-3 in Annex M, for each of the spurious emission frequency identified in step (a). Apply a measurement bandwidth according to Table 6.5.3.3.5-2 through Table 6.5.3.3.5-3.

8. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

NOTE 1: The frequency range defined in Table 6.5.3.3.5-2 through Table 6.5.3.3.5-3 may be split into ranges. For each range a different test system, e.g. antenna and/or chamber, may be used. To pass the test case all verdicts of the frequency ranges must pass.

NOTE 2: The coarse TRP measurement grid and corresponding offset dB value referred in step 7(a) above, for some valid grids can be found in TR 38.903 [20] section B.18.

NOTE 3: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

NOTE 4: If the (in-band) beam peak is within  $0^\circ \leq \theta \leq 90^\circ$ : perform first hemispherical TRP scan ( $0^\circ \leq \theta \leq 90^\circ$ ) in DUT Orientation 1 and second hemispherical TRP scan ( $90^\circ > \theta \geq 0^\circ$ ) in DUT Orientation 2. If the (in-band) beam peak is within  $90^\circ < \theta \leq 180^\circ$ : perform first hemispherical TRP scan ( $0^\circ \leq \theta \leq 90^\circ$ ) in DUT Orientation 2 and second hemispherical TRP scan ( $90^\circ > \theta \geq 0^\circ$ ) in DUT Orientation 1. The DUT with UBF activated needs to be re-positioned during the test.

#### 6.5.3.3.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with TRANSFORM\_PRECODER\_ENABLED condition in Table 4.6.3-118 PUSCH-Config and with the following exceptions:

Information element additionalSpectrumEmission is set to NS\_202. This can be set in SIB1 as part of the cell broadcast message. This exception indicates that the UE shall meet the additional spurious emission requirement for a specific deployment scenario.

**Table 6.5.3.3.4.3-1: AdditionalSpectrumEmission: Additional spurious emissions test requirement for "NS\_202"**

Derivation Path: TS 38.508-1 [10] clause 4.6.3, Table 4.6.3-1			
Information Element	Value/remark	Comment	Condition
additionalSpectrumEmission	2 (NS_202)		

Information element `additionalSpectrumEmission` is set to `NS_203`. This can be set in SIB1 as part of the cell broadcast message. This exception indicates that the UE shall meet the additional spurious emission requirement for a specific deployment scenario.

**Table 6.5.3.3.4-2: AdditionalSpectrumEmission: Additional spurious emissions test requirement for "NS\_203"**

Derivation Path: TS 38.508-1 [10] clause 4.6.3, Table 4.6.3-1			
Information Element	Value/remark	Comment	Condition
<code>additionalSpectrumEmission</code>	3 (NS_203)		

#### 6.5.3.3.5 Test requirement

This clause specifies the requirements for the specified NR band for Transmitter Additional Spurious emissions requirement with frequency range as indicated in Table 6.5.3.3.5-2 and Table 6.5.3.3.5-3.

The maximum TRP power of spurious emission for Transmitter Additional Spurious emissions, measured using RMS detector, shall not exceed the described value in Table 6.5.3.3.5-2 and Table 6.5.3.3.5-3.

The Transmitter Additional Spurious emissions limits in Table 6.5.3.3.5-2 and Table 6.5.3.3.5-3 apply for all transmitter band configurations (NRB) and channel bandwidths.

NOTE: For measurement conditions at the edge of each frequency range, the lowest frequency of the measurement position in each frequency range should be set at the lowest boundary of the frequency range plus MBW/2. The highest frequency of the measurement position in each frequency range should be set at the highest boundary of the frequency range minus MBW/2. MBW denotes the measurement bandwidth defined for the protected band.

**Table 6.5.3.3.5-1: Void**

**Table 6.5.3.3.5-2: Additional spurious emissions (NS\_202) test requirements**

Frequency Range	Maximum Level (dBm)	Measurement bandwidth	NOTE
$7.25 \text{ GHz} \leq f \leq 12.75 \text{ GHz}$	-10	100 MHz	
$12.75 \text{ GHz} \leq f \leq 23.45 \text{ GHz}$	-10 + 13	100 MHz	NOTE 1
$23.45 \text{ GHz} \leq f \leq 40.8 \text{ GHz}$	-10 + 13	100 MHz	NOTE 1
$40.8 \text{ GHz} \leq f \leq 2\text{nd harmonic of the upper frequency edge of the UL operating band}$	-10 + 13	100 MHz	NOTE 1
$23.6 \text{ GHz} \leq f \leq 24.0 \text{ GHz}$	+1 +0.3	200 MHz	NOTE 2
NOTE 1: 13 dB relaxation due to testability limit			
NOTE 2: 0.3 dB relaxation due to testability limit			

**Table 6.5.3.3.5-3: Additional spurious emissions (NS\_203) test requirements**

Frequency band (GHz)	Spectrum emission limit (dBm)	Measurement bandwidth	NOTE
$23.6 \leq f \leq 24.0$	+1 + 0.3	200 MHz	NOTE 1
NOTE 1: 0.3 dB relaxation due to testability limit			



## 6.5A Output RF spectrum emissions for CA

### 6.5A.1 Occupied bandwidth for CA

#### 6.5A.1.0 Minimum conformance requirements

The normative reference for this requirement is TS 38.101-2 [3] clause 6.5A.1.

##### 6.5A.1.0.0 General

The occupied bandwidth for UL CA is defined as a directional requirement. The requirement is verified in beam locked mode on beam peak direction. In case the CA configuration consists of a single UL CC, the occupied bandwidth requirement defined in subclause 6.5.1 applies.

##### 6.5A.1.0.1 Occupied bandwidth for intra-band contiguous UL CA

For intra-band contiguous UL carrier aggregation, the occupied bandwidth is a measure of the bandwidth containing 99 % of the total integrated power of the transmitted spectrum. The occupied bandwidth for UL CA shall be less than the UL aggregated channel bandwidth defined in clause 5.3A.

##### 6.5A.1.0.2 Occupied bandwidth for intra-band non-contiguous UL CA

TBD

#### 6.5A.1.1 Occupied bandwidth for CA (2UL CA)

*Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:*

- *Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 400MHz and for intra-band non-contiguous CA are TBD*
- *Measurement Uncertainties and Test Tolerances are FFS*
- *TP analysis is FFS*
- *For a transition period of 2 meeting cycles after the test case is complete, the stability and repeatability of test procedure with PHR (variant b) for Rel-15 UEs is under evaluation.*

##### 6.5A.1.1.1 Test purpose

To verify that the UE occupied bandwidth for all transmission bandwidth configurations supported by the UE are less than their specific limits.

##### 6.5A.1.1.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 2UL CA.

##### 6.5A.1.1.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.5A.1.0.

##### 6.5A.1.1.4 Test description

###### 6.5A.1.1.4.1 Initial condition

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, test channel bandwidths and sub-carrier spacing based on NR CA configuration specified in clause 5.5A. All of these configurations shall be tested with

applicable test parameters for each CA combination and subcarrier spacing, are shown in Table 6.5A.1.1.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.5A.1.1.4.1-1: Test Configuration Table**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.				Mid range		
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.				Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1.				Lowest		
Test Parameters						
Test ID	CC	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation (Note 1)
1	PCC	Default	Default	-	CP-OFDM QPSK	Outer_Full
	SCC				CP-OFDM QPSK	Outer_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.						
NOTE 2: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".						

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] clause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement Channel is set according to Table 6.5A.1.1.4.1-1.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in State RRC\_CONNECTED with generic procedure parameters Connectivity NR, Connected without release On, Test Mode On and Test Loop Function On according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.5A.1.1.4.3.

#### 6.5A.1.1.4.2 Test procedure

1. Configure SCC according to Annex C.0, C.1, C.2, and C.3.0 for all downlink physical channels.
2. The SS shall configure SCC as per TS 38.508-1 [10] clause 5.5.1. Message contents are defined in clause 6.5A.1.1.4.3.
3. Apply the test step based on the 5G NR UE Release:
  - 3a. For Release 16 and forward 5G NR UEs: SS applies a backoff on the PCell power by activating the UE Power Limit Function (UPLF). The ACTIVATE POWER LIMIT REQUEST procedure is performed as specified in TS 38.508-1 [10] clause 4.9.32 using condition 'NR FR2 2CA'. UE shall transmit ACTIVATE POWER LIMIT RESPONSE to SS. Go to step 4.
  - 3b. For Release 15 5G NR UEs: No action.
4. SS activates SCC by sending the activation MAC CE (Refer TS 38.321 [28], clauses 5.9, 6.1.3.10). Wait for at least 2 seconds (Refer TS 38.133[25], clause 9.2).
5. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.5A.1.1.4.1-1 on both PCC and SCC(s). Since the UE has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC.

6. Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
7. Apply the test step based on the 5G NR UE Release:
  - 7a. For Release 16 and forward 5G NR UEs: Send continuously uplink power control "up" commands in every uplink scheduling information to the UE; allow at least 200 ms for the UE to reach maximum output power. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
  - 7b. For Release 15 5G NR UEs: Send uplink power control commands in uplink scheduling information to the UE per UL CC until the Power Headroom Report (PHR) from the UE for each UL CC is at the target value according to Table 6.2A.2.1.4.2-1. ; allow at least 200 ms for the UE to reach maximum output power. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
8. Measure the EIRP spectrum distribution over all component carriers within 1.5 times or more frequency range over the requirement for Occupied Bandwidth for CA specification centring on the centre of aggregated channel bandwidth. The characteristics of the filter shall be approximately Gaussian (typical spectrum analyser filter). The measuring duration is one active uplink subframe. EIRP is captured from both polarizations, theta and phi.
9. Calculate the total EIRP from both polarizations, theta and phi, within the range of all frequencies measured in step 4 and save this value as "Total EIRP". EIRP measurement procedure is defined in Annex K.
10. Identify the measurement window whose centre is aligned on the centre of the channel for which the sum of the power measured in theta and phi polarization is 99% of the "Total EIRP".
11. The "Occupied Bandwidth" is the width of the measurement window obtained in step 9.
12. Apply the test step based on the 5G NR UE Release:
  - 12a. For Release 16 and forward 5G NR UEs: SS deactivates the UE Power Limit Function (UPLF) by performing the DEACTIVATE POWER LIMIT REQUEST procedure as specified in TS 38.508-1 [10] clause 4.9.33.
  - 12a. For Release 15 5G NR UEs: No action.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

#### 6.5A.1.1.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with the following exceptions for Release 15 5G NR UE.

**Table 6.5A.1.1.4.3: PUSCH-PowerControl**

Derivation Path: TS 38.508-1 [10], Table 4.6.3-120			
Information Element	Value/remark	Comment	Condition
PUSCH-PowerControl ::= SEQUENCE {			
tpc-Accumulation	disabled		
p0-AlphaSets SEQUENCE (SIZE (1..maxNrofP0-PUSCH-AlphaSets)) OF SEQUENCE {	1 entry		
P0-PUSCH-AlphaSet[1] SEQUENCE {			
alpha	alpha0		
}			
}			
}			

#### 6.5A.1.1.5 Test requirement

The measured Occupied Bandwidth shall not exceed the aggregated channel bandwidth defined in subclause 5.5A.

#### 6.5A.1.2 Occupied bandwidth for CA (3UL CA)

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 400MHz and for intra-band non-contiguous CA are TBD
- Measurement Uncertainties and Test Tolerances are FFS
- TP analysis is FFS

6.5A.1.2.1 Test purpose

To verify that the UE occupied bandwidth for all transmission bandwidth configurations supported by the UE are less than their specific limits.

6.5A.1.2.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 3UL CA.

6.5A.1.2.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.5A.1.0.

6.5A.1.2.4 Test description

Same as in clause 6.5A.1.1.4 with following exceptions:

- Instead of Table 6.5A.1.1.4.1-1 → use Table 6.5A.1.2.4-1.

**Table 6.5A.1.2.4-1: Test Configuration Table**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.				Mid range		
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.				Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1.				Lowest		
Test Parameters						
Test ID	CC	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation (Note 1)
1	PCC	Default	Default	-	CP-OFDM QPSK	Outer_Full
	SCC1				CP-OFDM QPSK	Outer_Full
	SCC2				CP-OFDM QPSK	Outer_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.						
NOTE 2: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".						

6.5A.1.2.5 Test requirement

The measured Occupied Bandwidth shall not exceed the aggregated channel bandwidth defined in subclause 5.5A.

6.5A.1.3 Occupied bandwidth for CA (4UL CA)

Editor’s note: This clause is incomplete. The following aspects are either missing or not yet determined:

- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 400MHz and for intra-band non-contiguous CA are TBD
- Measurement Uncertainties and Test Tolerances are FFS

- TP analysis is FFS
- This test case is incomplete until a suitable solution for preventing SCell drop is implemented in the test procedure.

6.5A.1.3.1 Test purpose

To verify that the UE occupied bandwidth for all transmission bandwidth configurations supported by the UE are less than their specific limits.

6.5A.1.3.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 4UL CA.

6.5A.1.3.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.5A.1.0.

6.5A.1.3.4 Test description

Same as in clause 6.5A.1.1.4 with following exceptions:

- Instead of Table 6.5A.1.1.4.1-1 → use Table 6.5A.1.3.4-1.

**Table 6.5A.1.3.4-1: Test Configuration Table**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.				Mid range		
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.				Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1.				Lowest		
Test Parameters						
Test ID	CC	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation (Note 1)
1	PCC	Default	Default	-	CP-OFDM QPSK	Outer_Full
	SCC1				CP-OFDM QPSK	Outer_Full
	SCC2				CP-OFDM QPSK	Outer_Full
	SCC3				CP-OFDM QPSK	Outer_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.						
NOTE 2: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".						

6.5A.1.3.5 Test requirement

The measured Occupied Bandwidth shall not exceed the aggregated channel bandwidth defined in subclause 5.5A.

6.5A.1.4 Occupied bandwidth for CA (5UL CA)

Editor’s note: This clause is incomplete. The following aspects are either missing or not yet determined:

- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 400MHz and for intra-band non-contiguous CA are TBD
- Measurement Uncertainties and Test Tolerances are FFS
- TP analysis is FFS

6.5A.1.4.1 Test purpose

To verify that the UE occupied bandwidth for all transmission bandwidth configurations supported by the UE are less than their specific limits.

6.5A.1.4.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 5UL CA.

6.5A.1.4.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.5A.1.0.

6.5A.1.4.4 Test description

Same as in clause 6.5A.1.1.4 with following exceptions:

- Instead of Table 6.5A.1.1.4.1-1 → use Table 6.5A.1.4.4-1.

**Table 6.5A.1.4.4-1: Test Configuration Table**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.				Mid range		
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.				Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1.				Lowest		
Test Parameters						
Test ID	CC	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation (Note 1)
1	PCC	Default	Default	-	CP-OFDM QPSK	Outer_Full
	SCC1				CP-OFDM QPSK	Outer_Full
	SCC2				CP-OFDM QPSK	Outer_Full
	SCC3				CP-OFDM QPSK	Outer_Full
	SCC4				CP-OFDM QPSK	Outer_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.						
NOTE 2: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".						

6.5A.1.4.5 Test requirement

The measured Occupied Bandwidth shall not exceed the aggregated channel bandwidth defined in subclause 5.5A.

6.5A.1.5 Occupied bandwidth for CA (6UL CA)

**Editor’s note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 400MHz and for intra-band non-contiguous CA are TBD
- Measurement Uncertainties and Test Tolerances are FFS
- TP analysis is FFS
- This test case is incomplete until a suitable solution for preventing SCell drop is implemented in the test procedure.

6.5A.1.5.1 Test purpose

To verify that the UE occupied bandwidth for all transmission bandwidth configurations supported by the UE are less than their specific limits.

6.5A.1.5.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 6UL CA.

6.5A.1.5.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.5A.1.0.

6.5A.1.5.4 Test description

Same as in clause 6.5A.1.1.4 with following exceptions:

- Instead of Table 6.5A.1.1.4.1-1 → use Table 6.5A.1.5.4-1.

**Table 6.5A.1.5.4-1: Test Configuration Table**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.				Mid range		
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.				Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1.				Lowest		
Test Parameters						
Test ID	CC	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation (Note 1)
1	PCC	Default	Default	-	CP-OFDM QPSK	Outer_Full
	SCC1				CP-OFDM QPSK	Outer_Full
	SCC2				CP-OFDM QPSK	Outer_Full
	SCC3				CP-OFDM QPSK	Outer_Full
	SCC4				CP-OFDM QPSK	Outer_Full
	SCC5				CP-OFDM QPSK	Outer_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.						
NOTE 2: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".						

6.5A.1.5.5 Test requirement

The measured Occupied Bandwidth shall not exceed the aggregated channel bandwidth defined in subclause 5.5A.

6.5A.1.6 Occupied bandwidth for CA (7UL CA)

**Editor’s note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 400MHz and for intra-band non-contiguous CA are TBD
- Measurement Uncertainties and Test Tolerances are FFS
- TP analysis is FFS

6.5A.1.6.1 Test purpose

To verify that the UE occupied bandwidth for all transmission bandwidth configurations supported by the UE are less than their specific limits.

6.5A.1.6.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 7UL CA.

6.5A.1.6.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.5A.1.0.

6.5A.1.6.4 Test description

Same as in clause 6.5A.1.1.4 with following exceptions:

- Instead of Table 6.5A.1.1.4.1-1 → use Table 6.5A.1.6.4-1.

**Table 6.5A.1.6.4-1: Test Configuration Table**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.				Mid range		
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.				Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1.				Lowest		
Test Parameters						
Test ID	CC	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation (Note 1)
1	PCC	Default	Default	-	CP-OFDM QPSK	Outer_Full
	SCC1				CP-OFDM QPSK	Outer_Full
	SCC2				CP-OFDM QPSK	Outer_Full
	SCC3				CP-OFDM QPSK	Outer_Full
	SCC4				CP-OFDM QPSK	Outer_Full
	SCC5				CP-OFDM QPSK	Outer_Full
	SCC6				CP-OFDM QPSK	Outer_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.						
NOTE 2: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".						

6.5A.1.6.5 Test requirement

The measured Occupied Bandwidth shall not exceed the aggregated channel bandwidth defined in subclause 5.5A.

6.5A.1.7 Occupied bandwidth for CA (8UL CA)

**Editor’s note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 400MHz and for intra-band non-contiguous CA are TBD
- Measurement Uncertainties and Test Tolerances are FFS
- TP analysis is FFS



- This test case is incomplete until a suitable solution for preventing SCell drop is implemented in the test procedure.

6.5A.1.7.1 Test purpose

To verify that the UE occupied bandwidth for all transmission bandwidth configurations supported by the UE are less than their specific limits.

6.5A.1.7.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 8UL CA.

6.5A.1.7.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.5A.1.0.

6.5A.1.7.4 Test description

Same as in clause 6.5A.1.1.4 with following exceptions:

- Instead of Table 6.5A.1.1.4.1-1 → use Table 6.5A.1.7.4-1.

**Table 6.5A.1.7.4-1: Test Configuration Table**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes.				Mid range		
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.				Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1.				Lowest		
Test Parameters						
Test ID	CC	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation (Note 1)
1	PCC	Default	Default	-	CP-OFDM QPSK	Outer_Full
	SCC1				CP-OFDM QPSK	Outer_Full
	SCC2				CP-OFDM QPSK	Outer_Full
	SCC3				CP-OFDM QPSK	Outer_Full
	SCC4				CP-OFDM QPSK	Outer_Full
	SCC5				CP-OFDM QPSK	Outer_Full
	SCC6				CP-OFDM QPSK	Outer_Full
	SCC7				CP-OFDM QPSK	Outer_Full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.						
NOTE 2: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".						

6.5A.1.7.5 Test requirement

The measured Occupied Bandwidth shall not exceed the aggregated channel bandwidth defined in subclause 5.5A.

## 6.5A.2 Out of band emission for CA

### 6.5A.2.1 Spectrum Emission Mask for CA

#### 6.5A.2.1.0 Minimum conformance requirements

The normative reference for this requirement is TS 38.101-2 [3] clause 6.5A.2.1.

##### 6.5A.2.1.0.0 General

The requirements specified in this clause shall apply if the UE has at least one of UL or DL configured for CA or if the UE is configured for single CC operation with different channel bandwidths in UL and DL carriers. In case the CA configuration consists of a single UL CC, spectrum emission mask defined in subclause 6.5.2.1 applies. Spectral emission mask requirements do not apply at any frequency where IBE requirements of clause 6.4A.2.3 apply.

The requirement is verified in beam locked mode with the test metric of TRP (Link=TX beam peak direction).

##### 6.5A.2.1.0.1 Spectrum emission mask for intra-band contiguous UL CA

For intra-band contiguous UL carrier aggregation, the spectrum emission mask of the UE applies to frequencies ( $\Delta f_{\text{OOB}}$ ) starting from the  $\pm$  edge of the UL aggregated channel bandwidth (Table 5.3A.4-1). For any bandwidth class defined in Table 5.3A.4-1, the UE emission shall not exceed the levels specified in Table 6.5A.2.1.0.1-1.

**Table 6.5A.2.1.0.1-1: General NR spectrum emission mask for intra-band contiguous CA in frequency range 2**

$\Delta f_{\text{OOB}}$ (MHz)	Any carrier aggregation bandwidth class	Measurement bandwidth
$\pm 0-0.1 \cdot BW_{\text{Channel\_CA}}$	-5	1 MHz
$\pm 0.1 \cdot BW_{\text{Channel\_CA}} - 2 \cdot BW_{\text{Channel\_CA}}$	-13	1 MHz
NOTE 1: (void)		

##### 6.5A.2.1.0.2 Spectrum emission mask for intra-band non-contiguous UL CA

TBD

#### 6.5A.2.1.1 Spectrum Emission Mask for CA (2UL CA)

**Editor's note: The following aspects are either missing or not yet determined:**

- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 400MHz
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4
- For a transition period until RAN#99, the stability and repeatability of test procedure with PHR (variant b) for Rel-15 UEs is under evaluation.
- Test for DL intra-band non-contiguous configurations with UL intra-band contiguous configuration is FFS.

##### 6.5A.2.1.1.1 Test purpose

To verify that the power of any UE emission shall not exceed specified levels for the specified channel bandwidth for CA.

##### 6.5A.2.1.1.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 2UL CA.

6.5A.2.1.1.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.5A.2.1.0.

6.5A.2.1.1.4 Test description

6.5A.2.1.1.4.1 Initial condition

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, test channel bandwidths and sub-carrier spacing based on NR CA configurations specified in clause 5.5A. All of these configurations shall be tested with applicable test parameters for each CA combination and subcarrier spacing, are shown in Table 6.5A.2.1.1.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.5A.2.1.1.4.1-1: Test Configuration Table**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 and 4.3.1.2.4 for different CA bandwidth classes.				For intra-band contiguous CA: Mid range. For intra-band non-contiguous CA: FFS.		
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 and 4.3.1.2.4 for the CA Configuration across bandwidth combination sets supported by the UE.				Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1.				Lowest, Highest		
Test Parameters						
Test ID	CC	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation (Note 1)
1	PCC	Default	Default	-	DFT-s-OFDM PI/2 BPSK	Outer_1RB_Left
	SCCs				DFT-s-OFDM PI/2 BPSK	Outer_1RB_Left
2	PCC				DFT-s-OFDM PI/2 BPSK	Outer_1RB_Right
	SCCs				DFT-s-OFDM PI/2 BPSK	Outer_1RB_Right
3	PCC				DFT-s-OFDM PI/2 BPSK	Outer_Full
	SCCs				DFT-s-OFDM PI/2 BPSK	Outer_Full
4	PCC				DFT-s-OFDM QPSK	Outer_1RB_Left
	SCCs				DFT-s-OFDM QPSK	Outer_1RB_Left
5	PCC				DFT-s-OFDM QPSK	Outer_1RB_Right
	SCCs				DFT-s-OFDM QPSK	Outer_1RB_Right
6	PCC				DFT-s-OFDM QPSK	Outer_Full
	SCCs				DFT-s-OFDM QPSK	Outer_Full
7	PCC				DFT-s-OFDM 16QAM	Outer_1RB_Left
	SCCs				DFT-s-OFDM 16QAM	Outer_1RB_Left
8	PCC				DFT-s-OFDM 16QAM	Outer_1RB_Right
	SCCs				DFT-s-OFDM 16QAM	Outer_1RB_Right

9	PCC				DFT-s-OFDM 16QAM	Outer_Full			
	SCCs				DFT-s-OFDM 16QAM	Outer_Full			
10	PCC				DFT-s-OFDM 64QAM	Outer_1RB_Left			
	SCCs				DFT-s-OFDM 64QAM	Outer_1RB_Left			
11	PCC				DFT-s-OFDM 64QAM	Outer_1RB_Right			
	SCCs				DFT-s-OFDM 64QAM	Outer_1RB_Right			
12	PCC				DFT-s-OFDM 64QAM	Outer_Full			
	SCCs				DFT-s-OFDM 64QAM	Outer_Full			
13	PCC				CP-OFDM QPSK	Outer_1RB_Left			
	SCCs				CP-OFDM QPSK	Outer_1RB_Left			
14	PCC				CP-OFDM QPSK	Outer_1RB_Right			
	SCCs				CP-OFDM QPSK	Outer_1RB_Right			
15	PCC				CP-OFDM QPSK	Outer_Full			
	SCCs				CP-OFDM QPSK	Outer_Full			
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.									

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement channels are set according to Table 6.5A.2.1.1.4.1-1.
5. Propagation conditions are set according to Annex B.0
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.5A.2.1.1.4.3

6.5A.2.1.1.4.2 Test procedure

1. Configure SCC according to Annex C.0, C.1, C.2, and C.3 for all downlink physical channels.
2. The SS shall configure SCC as per TS 38.508-1 [10] clause 5.5.1. Message contents are defined in clause 6.5A.2.1.1.4.3.
3. Apply the test step based on the 5G NR UE Release:
  - 3a. For Release 16 and forward 5G NR UEs: SS applies a backoff on the PCell power by activating the UE Power Limit Function (UPLF). The ACTIVATE POWER LIMIT REQUEST procedure is performed as specified in TS 38.508-1 [10] clause 4.9.32 using condition ‘NR FR2 2CA’. UE shall transmit ACTIVATE POWER LIMIT RESPONSE to SS. Go to step 4.
  - 3b. For Release 15 5G NR UEs: No action.
4. SS activates SCC by sending the activation MAC CE (Refer TS 38.321 [28], clauses 5.9, 6.1.3.10). Wait for at least 2 seconds (Refer TS 38.133[25], clause 9.3).
5. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.5A.2.1.1.4.1-1 on both PCC and SCC(s). Since the UE has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC.
6. Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 2) for the UE Tx beam selection to complete.

7. Apply the test step based on the 5G NR UE Release:
  - 7a. For Release 16 and forward 5G NR UEs: Send continuously uplink power control "up" commands in every uplink scheduling information to the UE; allow at least 200 ms for the UE to reach maximum output power. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 2) for the UE Tx beam selection to complete.
  - 7b. For Release 15 5G NR UEs: Send uplink power control commands in uplink scheduling information to the UE per UL CC until the Power Headroom Report (PHR) from the UE for each UL CC is at the target value according to Table 6.2A.2.1.4.2-1; allow at least 200 ms for the UE to reach maximum output power. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
8. Measure the TRP of the transmitted signal with a measurement filter of bandwidths according to Table 6.5A.2.1.1.5-1. The centre frequency of the filter shall be stepped in continuous steps according to the same table. TRP shall be recorded for each step. The measurement period shall capture the active time slots. Total radiated power is measured according to TRP measurement procedure defined in Annex K. The measurement grid used for TRP measurement defined in Annex M. TRP is calculated considering both polarizations, theta and phi.
9. Apply the test step based on the 5G NR UE Release:
  - 9a. For Release 16 and forward 5G NR UEs SS deactivates the UE Power Limit Function (UPLF) by performing the DEACTIVATE POWER LIMIT REQUEST procedure as specified in TS 38.508-1 [10] clause 4.9.33.
  - 9b. For Release 15 5G NR UEs: No action.

NOTE 1: When switching to DFT-s-OFDM waveform, as specified in Table 6.5A.2.1.1.4.1-1, send an NR RRCReconfiguration message according to TS 38.508-1 [10] clause 4.6.3 Table 4.6.3-118 PUSCH-Config with TRANSFORM\_PRECODER\_ENABLED condition.

NOTE 2: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

6.5A.2.1.1.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with the following exceptions for Release 15 5G NR UE.

6.5A.2.1.1.4.3-1: PUSCH-PowerControl

Derivation Path: TS 38.508-1 [10], Table 4.6.3-120			
Information Element	Value/remark	Comment	Condition
PUSCH-PowerControl ::= SEQUENCE {			
tpc-Accumulation	disabled		
p0-AlphaSets SEQUENCE (SIZE (1..maxNrofP0-PUSCH-AlphaSets)) OF SEQUENCE {	1 entry		
P0-PUSCH-AlphaSet[1] SEQUENCE {			
alpha	alpha0		
}			
}			
}			

6.5A.2.1.1.5 Test Requirements

The measured TRP of any UE emission derived in step 7, shall fulfil requirements in Table.6.5A.2.1.1.5-1.

Table 6.5A.2.1.1.5-1: General NR spectrum emission mask for intra-band contiguous CA in frequency range 2

$\Delta f_{\text{OoB}}$ (MHz)	Any carrier aggregation bandwidth class	Measurement bandwidth
$\pm 0.0.1 * BW_{\text{Channel\_CA}}$	-5 + TT	1 MHz
$\pm 0.1 * BW_{\text{Channel\_CA}} - 2 * BW_{\text{Channel\_CA}}$	-13 + TT	1 MHz
NOTE 1: TT for each frequency and channel bandwidth is specified in Table 6.5A.2.1.1.5-1a		
NOTE 2: If carrier leakage or I/Q image lands inside the spectrum occupied by the		

configured UL and DL CCs, exception to the general spectrum emission mask limit applies. For carrier leakage the requirements specified in section 6.4A.2.2.0 shall apply. For I/Q image the requirements specified in section 6.4A.2.3.0 shall apply.

NOTE 3: At the boundary of spectrum emission limit, the first and last measurement position with a 1 MHz filter is the inside of +0.5MHz and -0.5MHz, respectively.

NOTE 4: The measurements are to be performed above the upper edge of the aggregated channel bandwidth and below the lower edge of the aggregated channel bandwidth.

**Table 6.5A.2.1.1.5-1a: Test Tolerance (Aggregated BW ≤ 400MHz)**

Test Metric	FR2a	FR2b
IFF (Max device size ≤ 30 cm)	3.21 dB	3.46 dB

**6.5A.2.1.2 Spectrum Emission Mask for CA (3UL CA)**

*Editor’s note: This clause is incomplete. The following aspects are either missing or not yet determined:*

- *Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 400MHz and for intra-band non-contiguous CA are TBD.*
- *Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4*

**6.5A.2.1.2.1 Test purpose**

To verify that the power of any UE emission shall not exceed specified levels for the specified channel bandwidth for CA.

**6.5A.2.1.2.2 Test applicability**

This test case applies to all types of NR UE release 15 and forward that supports FR2 3UL CA.

**6.5A.2.1.2.3 Minimum conformance requirements**

The minimum conformance requirements are defined in clause 6.5A.2.1.0.

**6.5A.2.1.2.4 Test description**

Same as in clause 6.5A.2.1.1.4 with following exceptions:

- Instead of Table 6.5A.2.1.1.5-1 → use Table 6.5A.2.1.2.5-1.

**6.5A.2.1.2.5 Test Requirements**

The measured TRP of any UE emission derived in step 7, shall fulfil requirements in Table.6.5A.2.1.2.5-1.

**Table 6.5A.2.1.2.5-1: General NR spectrum emission mask for intra-band contiguous CA in frequency range 2**

$\Delta f_{\text{OoB}}$ (MHz)	Any carrier aggregation bandwidth class	Measurement bandwidth
$\pm 0.1 \cdot BW_{\text{Channel\_CA}}$	-5 + TT	1 MHz
$\pm 0.1 \cdot BW_{\text{Channel\_CA}} - 2 \cdot BW_{\text{Channel\_CA}}$	-13 + TT	1 MHz
NOTE 1: TT for each frequency and channel bandwidth is specified in Table 6.5A.2.1.2.5-1a NOTE 2: If carrier leakage or I/Q image lands inside the spectrum occupied by the configured UL and DL CCs, exception to the general spectrum emission mask limit applies. For carrier leakage the requirements specified in section 6.4A.2.2.0 shall apply. For I/Q image the requirements specified in section 6.4A.2.3.0 shall apply. NOTE 3: At the boundary of spectrum emission limit, the first and last measurement position with a 1 MHz filter is the inside of +0.5MHz and -0.5MHz, respectively.		

NOTE 4: The measurements are to be performed above the upper edge of the aggregated channel bandwidth and below the lower edge of the aggregated channel bandwidth

**Table 6.5A.2.1.2.5-1a: Test Tolerance (Aggregated BW ≤ 400MHz)**

Test Metric	FR2a	FR2b
IFF (Max device size ≤ 30 cm)	3.21 dB	3.46 dB

**6.5A.2.1.3 Spectrum Emission Mask for CA (4UL CA)**

Editor’s note: This clause is incomplete. The following aspects are either missing or not yet determined:

- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 400MHz and for intra-band non-contiguous CA are TBD.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4
- This test case is incomplete until a suitable solution for preventing SCell drop is implemented in the test procedure.

**6.5A.2.1.3.1 Test purpose**

To verify that the power of any UE emission shall not exceed specified levels for the specified channel bandwidth for CA.

**6.5A.2.1.3.2 Test applicability**

This test case applies to all types of NR UE release 15 and forward that supports FR2 4UL CA.

**6.5A.2.1.3.3 Minimum conformance requirements**

The minimum conformance requirements are defined in clause 6.5A.2.1.0.

**6.5A.2.1.3.4 Test description**

Same as in clause 6.5A.2.1.1.4 with following exceptions:

- Instead of Table 6.5A.2.1.1.5-1 → use Table 6.5A.2.1.3.5-1.

**6.5A.2.1.3.5 Test Requirements**

The measured TRP of any UE emission derived in step 7, shall fulfil requirements in Table.6.5A.2.1.3.5-1.

**Table 6.5A.2.1.3.5-1: General NR spectrum emission mask for intra-band contiguous CA in frequency range 2**

$\Delta f_{\text{OOB}}$ (MHz)	Any carrier aggregation bandwidth class	Measurement bandwidth
$\pm 0.0.1 * BW_{\text{Channel\_CA}}$	-5 + TT	1 MHz
$\pm 0.1 * BW_{\text{Channel\_CA}} - 2 * BW_{\text{Channel\_CA}}$	-13 + TT	1 MHz
NOTE 1: TT for each frequency and channel bandwidth is specified in Table 6.5A.2.1.3.5-1a NOTE 2: If carrier leakage or I/Q image lands inside the spectrum occupied by the configured UL and DL CCs, exception to the general spectrum emission mask limit applies. For carrier leakage the requirements specified in section 6.4A.2.2.0 shall apply. For I/Q image the requirements specified in section 6.4A.2.3.0 shall apply. NOTE 3: At the boundary of spectrum emission limit, the first and last measurement position with a 1 MHz filter is the inside of +0.5MHz and -0.5MHz, respectively. NOTE 4: The measurements are to be performed above the upper edge of the aggregated channel bandwidth and below the lower edge of the aggregated channel		

bandwidth

**Table 6.5A.2.1.3.5-1a: Test Tolerance (Aggregated BW ≤ 400MHz)**

Test Metric	FR2a	FR2b
IFF (Max device size ≤ 30 cm)	3.21 dB	3.46 dB

**6.5A.2.1.4 Spectrum Emission Mask for CA (5UL CA)**

Editor’s note: This clause is incomplete. The following aspects are either missing or not yet determined:

- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 400MHz and for intra-band non-contiguous CA are TBD.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4

**6.5A.2.1.4.1 Test purpose**

To verify that the power of any UE emission shall not exceed specified levels for the specified channel bandwidth for CA.

**6.5A.2.1.4.2 Test applicability**

This test case applies to all types of NR UE release 15 and forward that supports FR2 5UL CA.

**6.5A.2.1.4.3 Minimum conformance requirements**

The minimum conformance requirements are defined in clause 6.5A.2.1.0.

**6.5A.2.1.4.4 Test description**

Same as in clause 6.5A.2.1.1.4 with following exceptions:

- Instead of Table 6.5A.2.1.1.5-1 → use Table 6.5A.2.1.4.5-1.

**6.5A.2.1.4.5 Test Requirements**

The measured TRP of any UE emission derived in step 7, shall fulfil requirements in Table.6.5A.2.1.4.5-1.

**Table 6.5A.2.1.4.5-1: General NR spectrum emission mask for intra-band contiguous CA in frequency range 2**

$\Delta f_{\text{OoB}}$ (MHz)	Any carrier aggregation bandwidth class	Measurement bandwidth
$\pm 0-0.1 \cdot BW_{\text{Channel\_CA}}$	-5 + TT	1 MHz
$\pm 0.1 \cdot BW_{\text{Channel\_CA}} - 2 \cdot BW_{\text{Channel\_CA}}$	-13 + TT	1 MHz
NOTE 1: TT for each frequency and channel bandwidth is specified in Table 6.5A.2.1.4.5-1a NOTE 2: If carrier leakage or I/Q image lands inside the spectrum occupied by the configured UL and DL CCs, exception to the general spectrum emission mask limit applies. For carrier leakage the requirements specified in section 6.4A.2.2.0 shall apply. For I/Q image the requirements specified in section 6.4A.2.3.0 shall apply. NOTE 3: At the boundary of spectrum emission limit, the first and last measurement position with a 1 MHz filter is the inside of +0.5MHz and -0.5MHz, respectively. NOTE 4: The measurements are to be performed above the upper edge of the aggregated channel bandwidth and below the lower edge of the aggregated channel bandwidth		



**Table 6.5A.2.1.4.5-1a: Test Tolerance (Aggregated BW ≤ 400MHz)**

Test Metric	FR2a	FR2b
IFF (Max device size ≤ 30 cm)	3.21 dB	3.46 dB

### 6.5A.2.1.5 Spectrum Emission Mask for CA (6UL CA)

Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:

- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 400MHz and for intra-band non-contiguous CA TBD.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4
- This test case is incomplete until a suitable solution for preventing SCell drop is implemented in the test procedure.

#### 6.5A.2.1.5.1 Test purpose

To verify that the power of any UE emission shall not exceed specified levels for the specified channel bandwidth for CA.

#### 6.5A.2.1.5.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 6UL CA.

#### 6.5A.2.1.5.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.5A.2.1.0.

#### 6.5A.2.1.5.4 Test description

Same as in clause 6.5A.2.1.1.4 with following exceptions:

- Instead of Table 6.5A.2.1.1.5-1 → use Table 6.5A.2.1.5.5-1.

#### 6.5A.2.1.5.5 Test Requirements

The measured TRP of any UE emission derived in step 7, shall fulfil requirements in Table.6.5A.2.1.5.5-1.

**Table 6.5A.2.1.5.5-1: General NR spectrum emission mask for intra-band contiguous CA in frequency range 2**

$\Delta f_{\text{OoB}}$ (MHz)	Any carrier aggregation bandwidth class	Measurement bandwidth
$\pm 0-0.1 \cdot BW_{\text{Channel\_CA}}$	-5 + TT	1 MHz
$\pm 0.1 \cdot BW_{\text{Channel\_CA}} - 2 \cdot BW_{\text{Channel\_CA}}$	-13 + TT	1 MHz
NOTE 1: TT for each frequency and channel bandwidth is specified in Table 6.5A.2.1.5.5-1a NOTE 2: If carrier leakage or I/Q image lands inside the spectrum occupied by the configured UL and DL CCs, exception to the general spectrum emission mask limit applies. For carrier leakage the requirements specified in section 6.4A.2.2.0 shall apply. For I/Q image the requirements specified in section 6.4A.2.3.0 shall apply. NOTE 3: At the boundary of spectrum emission limit, the first and last measurement position with a 1 MHz filter is the inside of +0.5MHz and -0.5MHz, respectively. NOTE 4: The measurements are to be performed above the upper edge of the aggregated channel bandwidth and below the lower edge of the aggregated channel bandwidth		

**Table 6.5A.2.1.5.5-1a: Test Tolerance (Aggregated BW ≤ 400MHz)**

Test Metric	FR2a	FR2b
IFF (Max device size ≤ 30 cm)	3.21 dB	3.46 dB

6.5A.2.1.6 Spectrum Emission Mask for CA (7UL CA)

Editor’s note: This clause is incomplete. The following aspects are either missing or not yet determined:

- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 400MHz and for intra-band non-contiguous CA are TBD.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4

6.5A.2.1.6.1 Test purpose

To verify that the power of any UE emission shall not exceed specified levels for the specified channel bandwidth for CA.

6.5A.2.1.6.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 7UL CA.

6.5A.2.1.6.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.5A.2.1.0.

6.5A.2.1.6.4 Test description

Same as in clause 6.5A.2.1.1.4 with following exceptions:

- Instead of Table 6.5A.2.1.1.5-1 → use Table 6.5A.2.1.6.5-1.

6.5A.2.1.6.5 Test Requirements

The measured TRP of any UE emission derived in step 7, shall fulfil requirements in Table.6.5A.2.1.6.5-1.

**Table 6.5A.2.1.6.5-1: General NR spectrum emission mask for intra-band contiguous CA in frequency range 2**

$\Delta f_{\text{OoB}}$ (MHz)	Any carrier aggregation bandwidth class	Measurement bandwidth
$\pm 0.1 \cdot BW_{\text{Channel\_CA}}$	-5 + TT	1 MHz
$\pm 0.1 \cdot BW_{\text{Channel\_CA}} - 2 \cdot BW_{\text{Channel\_CA}}$	-13 + TT	1 MHz
NOTE 1: TT for each frequency and channel bandwidth is specified in Table 6.5A.2.1.6.5-1a NOTE 2: If carrier leakage or I/Q image lands inside the spectrum occupied by the configured UL and DL CCs, exception to the general spectrum emission mask limit applies. For carrier leakage the requirements specified in section 6.4A.2.2.0 shall apply. For I/Q image the requirements specified in section 6.4A.2.3.0 shall apply. NOTE 3: At the boundary of spectrum emission limit, the first and last measurement position with a 1 MHz filter is the inside of +0.5MHz and -0.5MHz, respectively. NOTE 4: The measurements are to be performed above the upper edge of the aggregated channel bandwidth and below the lower edge of the aggregated channel bandwidth		

**Table 6.5A.2.1.6.5-1a: Test Tolerance (Aggregated BW ≤ 400MHz)**

Test Metric	FR2a	FR2b
IFF (Max device size ≤ 30 cm)	3.21 dB	3.46 dB

6.5A.2.1.7 Spectrum Emission Mask for CA (8UL CA)

Editor’s note: This clause is incomplete. The following aspects are either missing or not yet determined:

- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 400MHz and for intra-band non-contiguous CA are TBD.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4
- This test case is incomplete until a suitable solution for preventing SCell drop is implemented in the test procedure.

6.5A.2.1.7.1 Test purpose

To verify that the power of any UE emission shall not exceed specified levels for the specified channel bandwidth for CA.

6.5A.2.1.7.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 8UL CA.

6.5A.2.1.7.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.5A.2.1.0.

6.5A.2.1.7.4 Test description

Same as in clause 6.5A.2.1.1.4 with following exceptions:

- Instead of Table 6.5A.2.1.1.5-1 → use Table 6.5A.2.1.7.5-1.

6.5A.2.1.7.5 Test Requirements

The measured TRP of any UE emission derived in step 7, shall fulfil requirements in Table.6.5A.2.1.7.5-1.

**Table 6.5A.2.1.7.5-1: General NR spectrum emission mask for intra-band contiguous CA in frequency range 2**

$\Delta f_{\text{foob}}$ (MHz)	Any carrier aggregation bandwidth class	Measurement bandwidth
$\pm 0.1 \cdot BW_{\text{Channel\_CA}}$	-5 + TT	1 MHz
$\pm 0.1 \cdot BW_{\text{Channel\_CA}} - 2 \cdot BW_{\text{Channel\_CA}}$	-13 + TT	1 MHz
NOTE 1: TT for each frequency and channel bandwidth is specified in Table 6.5A.2.1.7.5-1a NOTE 2: If carrier leakage or I/Q image lands inside the spectrum occupied by the configured UL and DL CCs, exception to the general spectrum emission mask limit applies. For carrier leakage the requirements specified in section 6.4A.2.2.0 shall apply. For I/Q image the requirements specified in section 6.4A.2.3.0 shall apply. NOTE 3: At the boundary of spectrum emission limit, the first and last measurement position with a 1 MHz filter is the inside of +0.5MHz and -0.5MHz, respectively. NOTE 4: The measurements are to be performed above the upper edge of the aggregated channel bandwidth and below the lower edge of the aggregated channel bandwidth		

**Table 6.5A.2.1.7.5-1a: Test Tolerance (Aggregated BW ≤ 400MHz)**

Test Metric	FR2a	FR2b
IFF (Max device size ≤ 30 cm)	3.21 dB	3.46 dB

## 6.5A.2.2 Adjacent channel leakage ratio for CA

### 6.5A.2.2.0 Minimum conformance requirements

The normative reference for this requirement is TS 38.101-2 [3] clause 6.5A.2.3.

#### 6.5A.2.2.0.1 Adjacent channel leakage ratio for intra-band contiguous UL CA

In case the CA configuration consists of a single UL CC, the adjacent channel leakage ratio defined in subclause 6.5.2.3 applies. For intra-band contiguous UL carrier aggregation, the carrier aggregation NR adjacent channel leakage power ratio (CA NR<sub>ACLR</sub>) is the ratio of the filtered mean power centred on the UL aggregated channel bandwidth to the filtered mean power centred on an adjacent UL aggregated channel bandwidth at spacing equal to the UL aggregated channel bandwidth. The assigned UL aggregated channel bandwidth power and adjacent UL aggregated channel bandwidth power are measured with rectangular filters with measurement bandwidths specified in Table 6.5A.2.2.0.1-1. If the measured adjacent channel power is greater than -35 dBm then the CA NR<sub>ACLR</sub> shall be higher than the value specified in Table 6.5A.2.2.0.1-1.

**Table 6.5A.2.2.0.1-1: General requirements for contiguous UL CA NR<sub>ACLR</sub>**

	CA bandwidth class / CA NR <sub>ACLR</sub> / Measurement bandwidth
	Any CA bandwidth class
CA NR <sub>ACLR</sub> for band n257, n258, n261	17 dB
CA NR <sub>ACLR</sub> for band n260	16 dB
NR channel measurement bandwidth <sup>1</sup>	$BW_{\text{Channel\_CA}} - 2 \cdot BW_{\text{GB}}$
Adjacent channel centre frequency offset (in MHz)	$\begin{matrix} + BW_{\text{Channel\_CA}} \\ / \\ - BW_{\text{Channel\_CA}} \end{matrix}$
NOTE 1: $BW_{\text{GB}}$ is defined in clause 5.3A.2.	

#### 6.5A.2.2.0.2 Adjacent channel leakage ratio for intra-band non-contiguous UL CA

TBD

#### 6.5A.2.2.1 Adjacent channel leakage ratio for CA (2UL CA)

**Editor's note: The following aspects are either missing or not yet determined:**

- Measurement Uncertainties and Test Tolerances and Test limit analysis for intra-band contiguous CA supporting aggregated BW > 400MHz is TBD.
- Measurement Uncertainties and Test Tolerances and Test limit analysis are FFS for power class 1, 2 and 4.
- -For a transition period until RAN#99, the stability and repeatability of test procedure with PHR (variant b) for Rel-15 UEs is under evaluation.
- Test for DL intra-band non-contiguous configurations with UL intra-band contiguous configuration is FFS.

##### 6.5A.2.2.1.1 Test purpose

To verify that UE transmitter does not cause unacceptable interference to adjacent channels in terms of Adjacent Channel Leakage power Ratio (ACLR) for CA.

##### 6.5A.2.2.1.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 2UL CA.

##### 6.5A.2.2.1.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.5A.2.2.0.

6.5A.2.2.1.4 Test description

6.5A.2.2.1.4.1 Initial condition

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, test channel bandwidths and sub-carrier spacing based on NR CA configurations specified in clause 5.5A. All of these configurations shall be tested with applicable test parameters for each CA combination and subcarrier spacing, are shown in Table 6.5A.2.2.1.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.5A.2.2.1.4.1-1: Test Configuration Table**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal			
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 and 4.3.1.2.4 for different CA bandwidth classes.			For intra-band contiguous CA: Low and High range. For intra-band non-contiguous CA: FFS.			
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 and 4.3.1.2.4 for the CA Configuration across bandwidth combination sets supported by the UE.			Highest aggregated BW of the CA configuration			
Test SCS as specified in Table 5.3.5-1.			Lowest, Highest			
Test Parameters						
Test ID	CC	ChBw(MHz)	Test frequency	DL RB allocation	UL Modulation	UL RB allocation (Note 1)
1	PCC	Default	Low	-	DFT-s-OFDM PI/2 BPSK	Outer_1RB_Left
	SCCs		Low		DFT-s-OFDM PI/2 BPSK	Outer_1RB_Left
2	PCC		High		DFT-s-OFDM PI/2 BPSK	Outer_1RB_Right
	SCCs		High		DFT-s-OFDM PI/2 BPSK	Outer_1RB_Right
3	PCC		Default		DFT-s-OFDM PI/2 BPSK	Outer_Full
	SCCs		Default		DFT-s-OFDM PI/2 BPSK	Outer_Full
4	PCC		Low		DFT-s-OFDM QPSK	Outer_1RB_Left
	SCCs		Low		DFT-s-OFDM QPSK	Outer_1RB_Left
5	PCC		High		DFT-s-OFDM QPSK	Outer_1RB_Right
	SCCs		High		DFT-s-OFDM QPSK	Outer_1RB_Right
6	PCC		Default		DFT-s-OFDM QPSK	Outer_Full
	SCCs		Default		DFT-s-OFDM QPSK	Outer_Full
7	PCC		Low		DFT-s-OFDM 16QAM	Outer_1RB_Left
	SCCs		Low		DFT-s-OFDM 16QAM	Outer_1RB_Left
8	PCC		High		DFT-s-OFDM 16QAM	Outer_1RB_Right
	SCCs		High		DFT-s-OFDM 16QAM	Outer_1RB_Right
9	PCC	Default	DFT-s-OFDM 16QAM	Outer_Full		
	SCCs	Default	DFT-s-OFDM 16QAM	Outer_Full		
10	PCC	Default	Default	DFT-s-OFDM	Outer_Full	

	SCCs	Default	64QAM	
			DFT-s-OFDM 64QAM	Outer_Full
11	PCC	Low	CP-OFDM QPSK	Outer_1RB_Left
	SCCs	Low	CP-OFDM QPSK	Outer_1RB_Left
12	PCC	High	CP-OFDM QPSK	Outer_1RB_Right
	SCCs	High	CP-OFDM QPSK	Outer_1RB_Right
13	PCC	Default	CP-OFDM QPSK	Outer_Full
	SCCs	Default	CP-OFDM QPSK	Outer_Full

NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.

NOTE 2: Following Test IDs shall be skipped for FR2b

- All Test IDs for  $100 \text{ MHz} < BW_{\text{Channel\_CA}} \leq 400 \text{ MHz}$
- Test ID 1-2, 4-5, 7-12 for  $50 \text{ MHz} < BW_{\text{Channel\_CA}} \leq 100 \text{ MHz}$

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement channels are set according to Table 6.5A.2.2.1.4.1-1.
5. Propagation conditions are set according to Annex B.0
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity NR, Connected without release On, Test Mode On and Test Loop Function On according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.5A.2.2.1.4.3

#### 6.5A.2.2.1.4.2 Test procedure

1. Configure SCC according to Annex C.0, C.1, C.2, and C.3 for all downlink physical channels.
2. The SS shall configure SCC as per TS 38.508-1 [10] clause 5.5.1. Message contents are defined in clause 6.5A.2.2.1.4.3.
3. Apply the test step based on the 5G NR UE Release:
  - 3a. For Release 16 and forward 5G NR UEs: SS applies a backoff on the PCell power by activating the UE Power Limit Function (UPLF). The ACTIVATE POWER LIMIT REQUEST procedure is performed as specified in TS 38.508-1 [10] clause 4.9.32 using condition 'NR FR2 2CA'. UE shall transmit ACTIVATE POWER LIMIT RESPONSE to SS. Go to step 4.
  - 3b. For Release 15 5G NR UEs: No action.
4. SS activates SCC by sending the activation MAC CE (Refer TS 38.321 [28], clauses 5.9, 6.1.3.10). Wait for at least 2 seconds (Refer TS 38.133[25], clause 9.3).
5. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.5A.2.2.1.4.1-1 on both PCC and SCC(s). Since the UE has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC.
6. Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 2) for the UE Tx beam selection to complete.
7. Apply the test step based on the 5G NR UE Release:
  - 7a. For Release 16 and forward 5G NR UEs: Send continuously uplink power control "up" commands in every uplink scheduling information to the UE; allow at least 200 ms for the UE to reach maximum output power. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 2) for the UE Tx beam selection to complete.
  - 7b. For Release 15 5G NR UEs: Send uplink power control commands in uplink scheduling information to the UE per UL CC until the Power Headroom Report (PHR) from the UE for each UL CC is at the target value

according to Table 6.2A.2.1.4.2-1; allow at least 200 ms for the UE to reach maximum output power. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.

8. Measure EIRP of the transmitted signal for the assigned NR channel with a rectangular measurement filter with bandwidths according to Table 6.5A.2.2.1.5-1. EIRP measurement procedure defined in Annex K. EIRP is calculated considering both polarizations, theta and phi.
9. Measure EIRP of the first NR adjacent channel on both lower and upper side of the assigned NR channel, respectively using a rectangular measurement filter with bandwidths according to Table 6.5A.2.2.1.5-1. EIRP measurement procedure defined in Annex K. EIRP is calculated considering both polarizations, theta and phi.
10. Calculate the ratios of the power between the values measured in step 7 over step 8 for lower and upper NR<sub>ACLR</sub>, respectively.
11. Apply the test step based on the 5G NR UE Release:
  - 11a. For Release 16 and forward 5G NR UEs: SS deactivates the UE Power Limit Function (UPLF) by performing the DEACTIVATE POWER LIMIT REQUEST procedure as specified in TS 38.508-1 [10] clause 4.9.33.
  - 11b. For Release 15 5G NR UEs: No action.

NOTE 1: When switching to DFT-s-OFDM waveform, as specified in Table 6.5A.2.2.1.4.1-1, send an NR RRCReconfiguration message according to TS 38.508-1 [10] clause 4.6.3 Table 4.6.3-118 PUSCH-Config with TRANSFORM\_PRECODER\_ENABLED condition.

NOTE 2: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

6.5A.2.2.1.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with the following exceptions for Release 15 5G NR UE.

**Table 6.5A.2.2.1.4.3-1: PUSCH-PowerControl**

Derivation Path: TS 38.508-1 [10], Table 4.6.3-120			
Information Element	Value/remark	Comment	Condition
PUSCH-PowerControl ::= SEQUENCE {			
tpc-Accumulation	disabled		
p0-AlphaSets SEQUENCE (SIZE (1..maxNrofP0-PUSCH-AlphaSets)) OF SEQUENCE {	1 entry		
P0-PUSCH-AlphaSet[1] SEQUENCE {			
alpha	alpha0		
}			
}			
}			

6.5A.2.2.1.5 Test Requirements

If the measured adjacent channel power, derived in step 8, is greater than -35 dBm then the measured NR<sub>ACLR</sub>, derived in step 9, shall be higher than the limits in Table 6.5A.2.2.1.5-1.

**Table 6.5A.2.2.1.5-1: General requirements for CA NR<sub>ACLR</sub>**

	CA bandwidth class / CA NR <sub>ACLR</sub> / Measurement bandwidth
	Any CA bandwidth class
CA NR <sub>ACLR</sub> for band n257, n258, n261	17 - TT- R dB
CA NR <sub>ACLR</sub> for band n260	16 - TT dB
NR channel measurement bandwidth <sup>1</sup>	BW <sub>Channel_CA</sub> - 2*BW <sub>GB</sub>
Adjacent channel centre frequency offset (in MHz)	+ BW <sub>Channel_CA</sub> / - BW <sub>Channel_CA</sub>
NOTE 1: BW <sub>GB</sub> is defined in clause 5.3A.2.	

NOTE 2: TT for each frequency and channel bandwidth is specified in Table 6.5A.2.2.1.5-1a  
 NOTE 3: R for each frequency, channel bandwidth and test point is specified in Table 6.5A.2.2.1.5-1b

**Table 6.5A.2.2.1.5-1a: Test Tolerance (Aggregated BW ≤ 400MHz)**

Test Metric	Any CA bandwidth class	23.45GHz ≤ f ≤ 30.3GHz	30.3GHz < f ≤ 40.8GHz
IFF (Max device size ≤ 30 cm)	BW <sub>Channel_CA</sub> ≤ 100 MHz	4.96 dB	4.96 dB
	100 MHz < BW <sub>Channel_CA</sub> ≤ 200 MHz	4.96 dB	4.96 dB
	200 MHz < BW <sub>Channel_CA</sub> ≤ 400 MHz	4.96 dB	4.96 dB

**Table 6.5A.2.2.1.5-1b: Relaxation due to testability limit (Aggregated BW ≤ 400MHz)**

	Test ID	Channel bandwidth / NR <sub>ACLR</sub> / Measurement bandwidth		
		BW <sub>Channel_CA</sub> ≤ 100 MHz	100 MHz < BW <sub>Channel_CA</sub> ≤ 200 MHz	200 MHz < BW <sub>Channel_CA</sub> ≤ 400 MHz
NR <sub>ACLR</sub> for band n257, n258, n261	1	0	3	6
	2	0	3	6
	3	0	0	3
	4	0	3	6
	5	0	3	6
	6	0	0	3
	7	0	3	6
	8	0	3	6
	9	0	2.5	5.5
	10	2	5	8
	11	0	3	6
	12	0	3	6
	13	0	0	3

NOTE 1: Relaxation value is 0 for FR2b.

### 6.5A.2.2.2 Adjacent channel leakage ratio for CA (3UL CA)

Editor's note: The following aspects are either missing or not yet determined:

- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 400MHz is TBD.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.
- This test case is incomplete until a suitable solution for preventing SCell drop is implemented in the test procedure.

#### 6.5A.2.2.2.1 Test purpose

To verify that UE transmitter does not cause unacceptable interference to adjacent channels in terms of Adjacent Channel Leakage power Ratio (ACLR) for CA.

#### 6.5A.2.2.2.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 3UL CA.

#### 6.5A.2.2.2.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.5A.2.2.0.



## 6.5A.2.2.2.4 Test description

Same as in clause 6.5A.2.2.1.4 with following exceptions:

- Instead of Table 6.5A.2.2.1.5-1 → use Table 6.5A.2.2.2.5-1.

## 6.5A.2.2.2.5 Test Requirements

If the measured adjacent channel power, derived in step 8, is greater than -35 dBm then the measured NR ACLR, derived in step 9, shall be higher than the limits in Table 6.5A.2.2.2.5-1.

**Table 6.5A.2.2.2.5-1: General requirements for CA NR<sub>ACLR</sub>**

	CA bandwidth class / CA NR <sub>ACLR</sub> / Measurement bandwidth
	Any CA bandwidth class
CA NR <sub>ACLR</sub> for band n257, n258, n261	17 - TT - R dB
CA NR <sub>ACLR</sub> for band n260	16 - TT dB
NR channel measurement bandwidth <sup>1</sup>	$BW_{\text{Channel\_CA}} - 2 \cdot BW_{\text{GB}}$
Adjacent channel centre frequency offset (in MHz)	+ $BW_{\text{Channel\_CA}}$ / - $BW_{\text{Channel\_CA}}$
NOTE 1: $BW_{\text{GB}}$ is defined in clause 5.3A.2.	
NOTE 2: TT for each frequency and channel bandwidth is specified in Table 6.5A.2.2.2.5-1a	
NOTE 3: R for each frequency, channel bandwidth and test point is specified in Table 6.5A.2.2.1.5-1b	

**Table 6.5A.2.2.2.5-1a: Test Tolerance (Aggregated BW ≤ 400MHz)**

Test Metric	Any CA bandwidth class	23.45GHz ≤ f ≤ 30.3GHz	30.3GHz < f ≤ 40.8GHz
IFF (Max device size ≤ 30 cm)	$BW_{\text{Channel\_CA}} \leq 100$ MHz	4.96 dB	4.96 dB
	100 MHz < $BW_{\text{Channel\_CA}} \leq 200$ MHz	4.96 dB	4.96 dB
	200 MHz < $BW_{\text{Channel\_CA}} \leq 400$ MHz	4.96 dB	4.96 dB

## 6.5A.2.2.3 Adjacent channel leakage ratio for CA (4UL CA)

Editor's note: The following aspects are either missing or not yet determined:

- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 400MHz is TBD.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.
- This test case is incomplete until a suitable solution for preventing SCell drop is implemented in the test procedure.

## 6.5A.2.2.3.1 Test purpose

To verify that UE transmitter does not cause unacceptable interference to adjacent channels in terms of Adjacent Channel Leakage power Ratio (ACLR) for CA.

## 6.5A.2.2.3.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 4UL CA.

## 6.5A.2.2.3.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.5A.2.2.0.

## 6.5A.2.2.3.4 Test description

Same as in clause 6.5A.2.2.1.4 with following exceptions:

- Instead of Table 6.5A.2.2.1.5-1 → use Table 6.5A.2.2.3.5-1.

## 6.5A.2.2.3.5 Test Requirements

If the measured adjacent channel power, derived in step 8, is greater than -35 dBm then the measured NR ACLR, derived in step 9, shall be higher than the limits in Table 6.5A.2.2.3.5-1.

**Table 6.5A.2.2.3.5-1: General requirements for CA NR<sub>ACLR</sub>**

	CA bandwidth class / CA NR <sub>ACLR</sub> / Measurement bandwidth
	Any CA bandwidth class
CA NR <sub>ACLR</sub> for band n257, n258, n261	17 - TT - R dB
CA NR <sub>ACLR</sub> for band n260	16 - TT dB
NR channel measurement bandwidth <sup>1</sup>	$BW_{\text{Channel\_CA}} - 2 \cdot BW_{\text{GB}}$
Adjacent channel centre frequency offset (in MHz)	+ $BW_{\text{Channel\_CA}}$ / - $BW_{\text{Channel\_CA}}$
NOTE 1: $BW_{\text{GB}}$ is defined in clause 5.3A.2.	
NOTE 2: TT for each frequency and channel bandwidth is specified in Table 6.5A.2.2.3.5-1a	
NOTE 3: R for each frequency, channel bandwidth and test point is specified in Table 6.5A.2.2.1.5-1b	

**Table 6.5A.2.2.3.5-1a: Test Tolerance (Aggregated BW ≤ 400MHz)**

Test Metric	Any CA bandwidth class	23.45GHz ≤ f ≤ 30.3GHz	30.3GHz < f ≤ 40.8GHz
IFF (Max device size ≤ 30 cm)	$BW_{\text{Channel\_CA}} \leq 100$ MHz	4.96 dB	4.96 dB
	100 MHz < $BW_{\text{Channel\_CA}} \leq 200$ MHz	4.96 dB	4.96 dB
	200 MHz < $BW_{\text{Channel\_CA}} \leq 400$ MHz	4.96 dB	4.96 dB

## 6.5A.2.2.4 Adjacent channel leakage ratio for CA (5UL CA)

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- Measurement Uncertainties and Test Tolerances are TBD.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4
- This test case is incomplete until a suitable solution for preventing SCell drop is implemented in the test procedure.

## 6.5A.2.2.4.1 Test purpose

To verify that UE transmitter does not cause unacceptable interference to adjacent channels in terms of Adjacent Channel Leakage power Ratio (ACLR) for CA.

## 6.5A.2.2.4.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 5UL CA.

## 6.5A.2.2.4.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.5A.2.2.0.

6.5A.2.2.4.4 Test description

Same as in clause 6.5A.2.2.1.4 with following exceptions:

- Instead of Table 6.5A.2.2.1.5-1 → use Table 6.5A.2.2.4.5-1.

6.5A.2.2.4.5 Test Requirements

If the measured adjacent channel power, derived in step 8, is greater than -35 dBm then the measured NR ACLR, derived in step 9, shall be higher than the limits in Table 6.5A.2.2.4.5-1.

**Table 6.5A.2.2.4.5-1: General requirements for CA NR<sub>ACLR</sub>**

	CA bandwidth class / CA NR <sub>ACLR</sub> / Measurement bandwidth
	Any CA bandwidth class
CA NR <sub>ACLR</sub> for band n257, n258, n261	17 – TT dB
CA NR <sub>ACLR</sub> for band n260	16 – TT dB
NR channel measurement bandwidth <sup>1</sup>	$BW_{\text{Channel\_CA}} - 2 \cdot BW_{\text{GB}}$
Adjacent channel centre frequency offset (in MHz)	+ $BW_{\text{Channel\_CA}}$ / - $BW_{\text{Channel\_CA}}$
NOTE 1: $BW_{\text{GB}}$ is defined in clause 5.3A.2.	
NOTE 2: TT for each frequency and channel bandwidth is specified in Table 6.5A.2.2.4.5-1a	

**Table 6.5A.2.2.4.5-1a: Test Tolerance (Aggregated BW ≤ 400MHz)**

Test Metric	FR2a	FR2b
IFF (Max device size ≤ 30 cm)	[4.6] dB	[5.0] dB

6.5A.2.2.5 Adjacent channel leakage ratio for CA (6UL CA)

**Editor’s note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- Measurement Uncertainties and Test Tolerances are TBD.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4

6.5A.2.2.5.1 Test purpose

To verify that UE transmitter does not cause unacceptable interference to adjacent channels in terms of Adjacent Channel Leakage power Ratio (ACLR) for CA.

6.5A.2.2.5.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 6UL CA.

6.5A.2.2.5.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.5A.2.2.0.

6.5A.2.2.5.4 Test description

Same as in clause 6.5A.2.2.1.4 with following exceptions:

- Instead of Table 6.5A.2.2.1.5-1 → use Table 6.5A.2.2.5.5-1.

## 6.5A.2.2.5.5 Test Requirements

If the measured adjacent channel power, derived in step 8, is greater than -35 dBm then the measured NR ACLR, derived in step 9, shall be higher than the limits in Table 6.5A.2.2.5.5-1.

**Table 6.5A.2.2.5.5-1: General requirements for CA NR<sub>ACLR</sub>**

	CA bandwidth class / CA NR <sub>ACLR</sub> / Measurement bandwidth
	Any CA bandwidth class
CA NR <sub>ACLR</sub> for band n257, n258, n261	17 – TT dB
CA NR <sub>ACLR</sub> for band n260	16 – TT dB
NR channel measurement bandwidth <sup>1</sup>	$BW_{\text{Channel\_CA}} - 2 \cdot BW_{\text{GB}}$
Adjacent channel centre frequency offset (in MHz)	+ $BW_{\text{Channel\_CA}}$ / - $BW_{\text{Channel\_CA}}$
NOTE 1: $BW_{\text{GB}}$ is defined in clause 5.3A.2.	
NOTE 2: TT for each frequency and channel bandwidth is specified in Table 6.5A.2.2.5.5-1a	

**Table 6.5A.2.2.5.5-1a: Test Tolerance (Aggregated BW ≤ 400MHz)**

Test Metric	FR2a	FR2b
IFF (Max device size ≤ 30 cm)	[4.6] dB	[5.0] dB

## 6.5A.2.2.6 Adjacent channel leakage ratio for CA (7UL CA)

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- **Measurement Uncertainties and Test Tolerances are TBD.**
- **Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4**
- **This test case is incomplete until a suitable solution for preventing SCell drop is implemented in the test procedure.**

## 6.5A.2.2.6.1 Test purpose

To verify that UE transmitter does not cause unacceptable interference to adjacent channels in terms of Adjacent Channel Leakage power Ratio (ACLR) for CA.

## 6.5A.2.2.6.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 7UL CA.

## 6.5A.2.2.6.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.5A.2.2.0.

## 6.5A.2.2.6.4 Test description

Same as in clause 6.5A.2.2.1.4 with following exceptions:

- Instead of Table 6.5A.2.2.1.5-1 → use Table 6.5A.2.2.6.5-1.

## 6.5A.2.2.6.5 Test Requirements

If the measured adjacent channel power, derived in step 8, is greater than -35 dBm then the measured NR ACLR, derived in step 9, shall be higher than the limits in Table 6.5A.2.2.6.5-1.

**Table 6.5A.2.2.6.5-1: General requirements for CA NR<sub>ACLR</sub>**

	CA bandwidth class / CA NR <sub>ACLR</sub> / Measurement bandwidth
	Any CA bandwidth class
CA NR <sub>ACLR</sub> for band n257, n258, n261	17 – TT dB
CA NR <sub>ACLR</sub> for band n260	16 – TT dB
NR channel measurement bandwidth <sup>1</sup>	$BW_{\text{Channel\_CA}} - 2 \cdot BW_{\text{GB}}$
Adjacent channel centre frequency offset (in MHz)	+ $BW_{\text{Channel\_CA}}$ / - $BW_{\text{Channel\_CA}}$
NOTE 1: $BW_{\text{GB}}$ is defined in clause 5.3A.2.	
NOTE 2: TT for each frequency and channel bandwidth is specified in Table 6.5A.2.2.6.5-1a	

**Table 6.5A.2.2.6.5-1a: Test Tolerance (Aggregated BW ≤ 400MHz)**

Test Metric	FR2a	FR2b
IFF (Max device size ≤ 30 cm)	[4.6] dB	[5.0] dB

### 6.5A.2.2.7 Adjacent channel leakage ratio for CA (8UL CA)

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- Measurement Uncertainties and Test Tolerances are TBD.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4

#### 6.5A.2.2.7.1 Test purpose

To verify that UE transmitter does not cause unacceptable interference to adjacent channels in terms of Adjacent Channel Leakage power Ratio (ACLR) for CA.

#### 6.5A.2.2.7.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 8UL CA.

#### 6.5A.2.2.7.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.5A.2.2.0.

#### 6.5A.2.2.7.4 Test description

Same as in clause 6.5A.2.2.1.4 with following exceptions:

- Instead of Table 6.5A.2.2.1.5-1 → use Table 6.5A.2.2.7.5-1.

#### 6.5A.2.2.7.5 Test Requirements

If the measured adjacent channel power, derived in step 8, is greater than -35 dBm then the measured NR ACLR, derived in step 9, shall be higher than the limits in Table 6.5A.2.2.7.5-1.

**Table 6.5A.2.2.7.5-1: General requirements for CA NR<sub>ACLR</sub>**

	CA bandwidth class / CA NR <sub>ACLR</sub> / Measurement bandwidth
	Any CA bandwidth class
CA NR <sub>ACLR</sub> for band n257, n258, n261	17 – TT dB
CA NR <sub>ACLR</sub> for band n260	16 – TT dB
NR channel measurement bandwidth <sup>1</sup>	$BW_{\text{Channel\_CA}} - 2 \cdot BW_{\text{GB}}$
Adjacent channel centre frequency offset (in MHz)	+ $BW_{\text{Channel\_CA}}$ / -

	- $BW_{\text{Channel\_CA}}$
NOTE 1: $BW_{\text{GB}}$ is defined in clause 5.3A.2.	
NOTE 2: TT for each frequency and channel bandwidth is specified in Table 6.5A.2.2.7.5-1a	

**Table 6.5A.2.2.7.5-1a: Test Tolerance (Aggregated BW  $\leq$  400MHz)**

Test Metric	FR2a	FR2b
IFF (Max device size $\leq$ 30 cm)	[4.6] dB	[5.0] dB

## 6.5A.3 Spurious emissions for CA

### 6.5A.3.1 General spurious emissions for CA

#### 6.5A.3.1.0 Minimum conformance requirements

The normative reference for this requirement is TS 38.101-2 [3] clause 6.5A.3.

##### 6.5A.3.1.0.0 General

This clause specifies the spurious emission requirements for carrier aggregation. The requirement is verified in beam locked mode with the test metric of TRP (Link=TX beam peak direction, Meas=TRP grid). The TX beam peak direction used for CA testing is the [same as that found for single carrier scenario in clause 6.5.3].

In case the CA configuration consists of a single UL CC, spurious emissions requirements defined in subclause 6.5.3 apply. Spurious emissions requirements do not apply at any frequency where IBE requirements of clause 6.4A.2.3 apply.

**NOTE:** For measurement conditions at the edge of each frequency range, the lowest frequency of the measurement position in each frequency range should be set at the lowest boundary of the frequency range plus  $MBW/2$ . The highest frequency of the measurement position in each frequency range should be set at the highest boundary of the frequency range minus  $MBW/2$ . MBW denotes the measurement bandwidth defined for the protected band.

##### 6.5A.3.1.0.1 Spurious emissions for intra-band contiguous UL CA

For intra-band contiguous UL carrier aggregation, the spurious emission limits apply for the frequency ranges that are more than  $F_{\text{OOB}}$  (MHz) from the edge of the UL aggregated channel bandwidth, where  $F_{\text{OOB}}$  is defined as the twice the UL aggregated channel bandwidth. For frequencies  $\Delta f_{\text{OOB}}$  greater than  $F_{\text{OOB}}$ , the spurious emission requirements in Table 6.5.3.1.3-2 are applicable.

##### 6.5A.3.1.0.2 Spurious emissions for intra-band non-contiguous UL CA

TBD

##### 6.5A.3.1.1 General spurious emissions for CA (2UL CA)

**Editor's note:** The following aspects are either missing or not yet determined:

- The testability of this test case is pending further analysis on relaxation of the requirement for band other than n257, n258, n260 and n261.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2, and 4.
- Connection diagram between SS and UE in TS 38.508-1 [10] Annex A is FFS.
- Test procedure only includes the testing of smartphone and is FFS for laptop and FWA.
- For a transition period until RAN#99, the stability and repeatability of test procedure with PHR (variant b) for Rel-15 UEs is under evaluation.

6.5A.3.1.1.1 Test purpose

To verify that UE transmitter does not cause unacceptable interference to other channels or other systems in terms of transmitter spurious emissions.

6.5A.3.1.1.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 2UL CA.

6.5A.3.1.1.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.5A.3.1.0.

6.5A.3.1.1.4 Test description

6.5A.3.1.1.4.1 Initial condition

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, and channel bandwidths based on NR operating bands specified in clause 5.5A. All of these configurations shall be tested with applicable test parameters for each channel bandwidth and subcarrier spacing, are shown in Table 6.5A.3.1.1.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.5A.3.1.1.4.1-1: Test Configuration Table**

Initial Conditions				
Test Environment as specified in TS 38.508-1 [10] subclause 4.1		Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes		Low range, High range (NOTE 2)		
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.		Highest aggregated BW of the CA configuration		
Test SCS as specified in Table 5.3.5-1		120kHz		
Test Parameters				
Test ID	CC	Downlink Configuration	UL Modulation	UL RB allocation (NOTE 1)
1	PCC	-	DFT-s-OFDM QPSK	Outer_Full
	SCCs		DFT-s-OFDM QPSK	Outer_Full
2	PCC		DFT-s-OFDM QPSK	Inner_1RB for PC2, PC3 and PC4 Inner_Partial for PC1 (NOTE 3)
	SCCs		DFT-s-OFDM QPSK	Inner_1RB for PC2, PC3 and PC4 Inner_Partial for PC1 (NOTE 3)
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.				
NOTE 2: When testing Low range test only in Frequency Range lower than ( $F_{UL\_low} - \Delta f_{OoB}$ ) and when testing High range test only in Frequency Range higher than ( $F_{UL\_high} + \Delta f_{OoB}$ ).				
NOTE 3: When testing Low range configure uplink RB to Inner_1RB_Left for PC2, PC3 and PC4 or Inner_Partial_Left_Region1 for PC1 and when testing High range configure uplink RB to Inner_1RB_Right for PC2, PC3 and PC4 or Inner_Partial_Right_Region1 for PC1.				
NOTE 4: The number of DL CCs shall be configured the same as the number of UL CCs. The requirements are applicable as per 5.3A.4 "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".				

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure [TBD] for TE diagram and Figure [TBD] for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement channels are set according to Table 6.5A.3.1.1.4.1-1.
5. Propagation conditions are set according to Annex B.0
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.5A.3.1.1.4.3

#### 6.5A.3.1.1.4.2 Test procedure

1. Select any of the three Alignment Options (1, 2, or 3) from Tables N.2-1 through N.2-3 to mount the DUT inside the QZ.
2. If the re-positioning concept is applied, position the device in DUT Orientation 1 if the maximum beam peak direction is within zenith angular range  $0^\circ \leq \theta \leq 90^\circ$  for the alignment option selected in step 1; position the device in DUT Orientation 2 (either Options 1 or 2) if the maximum beam peak direction is within zenith angular range  $90^\circ < \theta \leq 180^\circ$  for DUT Orientation 1 for the alignment option selected in step 1. If the re-positioning concept is not applied, position the device in DUT Orientation 1.
3. Configure SCC according to Annex C.0, C.1, C.2 for all downlink physical channels.
4. The SS shall configure SCC as per TS 38.508-1 [10] clause 5.5.1. Message contents are defined in clause 6.5A.3.1.1.4.3.
5. Apply the test step based on the 5G NR UE Release:
  - 5a. For Release 16 and forward 5G NR UEs: SS applies a backoff on the PCell power by activating the UE Power Limit Function (UPLF). The ACTIVATE POWER LIMIT REQUEST procedure is performed as specified in TS 38.508-1 [10] clause 4.9.32 using condition 'NR FR2 2CA'. UE shall transmit ACTIVATE POWER LIMIT RESPONSE to SS. Go to step 6.
  - 5b. For Release 15 5G NR UEs: No action.
6. SS activates SCC by sending the activation MAC CE (Refer TS 38.321 [28], clauses 5.9, 6.1.3.10). Wait for at least 2 seconds (Refer TS 38.133[25], clause 9.3).
7. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.5A.3.1.1.4.1-1. Since the UL has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC.
8. Set the UE in the Inband Tx beam peak direction [(same as that found for single carrier in clause 6.5.3)] found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 3) for the UE Tx beam selection to complete.
9. Apply the test step based on the 5G NR UE Release:
  - 9a. For Release 16 and forward 5G NR UEs: Send continuously uplink power control "up" commands in every uplink scheduling information to the UE; allow at least 200msec for the UE to reach  $P_{UMAX}$ . Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 3) for the UE Tx beam selection to complete.
  - 9b. For Release 15 5G NR UEs: Send uplink power control commands in uplink scheduling information to the UE per UL CC until the Power Headroom Report (PHR) from the UE for each UL CC is at the target value according to Table 6.2A.2.1.4.2-1; allow at least 200 ms for the UE to reach maximum output power. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
10. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.



11. Measure the spurious emissions as per steps outlined below with an exception to the procedure in Annex K if the re-positioning concept is applied (NOTE 4):

- (a) Perform coarse TRP measurements to identify spurious emission frequencies and corresponding power level according to the procedures in Annex L, using coarse TRP measurement grid selection criteria as per Table M.4.5-3 in Annex M. The measurement is completed in both polarizations  $\theta$  and  $\phi$  over frequency range and measurement bandwidth according to Table 6.5A.3.1.1.5-1. Optionally, a larger and non-constant measurement bandwidth than that of Table 6.5A.3.1.1.5-1 may be applied as long as the SNR (ratio of test limit to floor noise of test equipment)  $\geq 10$ dB is guaranteed. The measurement period shall capture the [active time slots]. For each spurious emission frequency with coarse TRP identified to be less than an offset dB (NOTE 2) from the TRP limit according to Table 6.5A.3.1.1.5-1, continue with fine TRP procedures according to step (b).

The offset value shall be the TRP measurement uncertainty at 95% confidence level including the effect of coarse grid measurement uncertainty element. Different coarse TRP grids and corresponding offset values may be used for different frequencies. The coarse TRP grid and offset values used shall be recorded in the test report.

- (b) Measure fine TRP measurements according to procedures in Annex K, using fine TRP measurement grid selection criteria as per Table M.4.5-3 in Annex M, for each of the spurious emission frequency identified in step (a). Apply a measurement bandwidth according to Table 6.5A.3.1.1.5-1.

12. Apply the test step based on the 5G NR UE Release:

- 12a. For Release 16 and forward 5G NR UEs SS deactivates the UE Power Limit Function (UPLF) by performing the DEACTIVATE POWER LIMIT REQUEST procedure as specified in TS 38.508-1 [10] clause 4.9.33.

- 12b. For Release 15 5G NR UEs: No action.

13. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

NOTE 1: The frequency range defined in Table 6.5A.3.1.1.5-1 may be split into ranges. For each range a different test system, e.g. antenna and/or chamber, may be used. To pass the test case all verdicts of the frequency ranges must pass.

NOTE 2: The coarse TRP measurement grid and corresponding offset dB value referred in step 10(a) above, for some valid grids can be found in TR 38.903 section B.18.

NOTE 3: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

NOTE 4: If the (in-band) beam peak is within  $0^\circ \leq \theta \leq 90^\circ$ : perform first hemispherical TRP scan ( $0^\circ \leq \theta \leq 90^\circ$ ) in DUT Orientation 1 and second hemispherical TRP scan ( $90^\circ > \theta \geq 0^\circ$ ) in DUT Orientation 2. If the (in-band) beam peak is within  $90^\circ < \theta \leq 180^\circ$ : perform first hemispherical TRP scan ( $0^\circ \leq \theta \leq 90^\circ$ ) in DUT Orientation 2 and second hemispherical TRP scan ( $90^\circ > \theta \geq 0^\circ$ ) in DUT Orientation 1. The DUT with UBF activated needs to be re-positioned during the test.

#### 6.5A.3.1.1.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with TRANSFORM\_PRECODER\_ENABLED condition in Table 4.6.3-118 PUSCH-Config with the following exceptions for Release 15 5G NR UE.

**Table 6.5A.3.1.1.4.3-1: PUSCH-PowerControl**

Derivation Path: TS 38.508-1 [10], Table 4.6.3-120			
Information Element	Value/remark	Comment	Condition
PUSCH-PowerControl ::= SEQUENCE {			
tpc-Accumulation	disabled		
p0-AlphaSets SEQUENCE (SIZE (1..maxNrofP0-PUSCH-AlphaSets)) OF SEQUENCE {	1 entry		
P0-PUSCH-AlphaSet[1] SEQUENCE {			
alpha	alpha0		
}			
}			

}		
}		

6.5A.3.1.1.5 Test Requirements

This clause specifies the requirements for the specified NR band for Transmitter Spurious emissions requirement with frequency range as indicated in Table 6.5A.3.1.1.5-1.

The maximum TRP power of spurious emission, measured using RMS detector, shall not exceed the described value in Table 6.5A.3.1.1.5-1.

Unless otherwise stated, the spurious emission limits apply for the frequency ranges that are more than F<sub>OOB</sub> (MHz) in Table 6.5.3.1.3-1 starting from the edge of the assigned NR channel bandwidth. The spurious emission limits in Table 6.5A.3.1.1.5-1 apply for all transmitter band configurations (NRB) and channel bandwidths.

NOTE: For measurement conditions at the edge of each frequency range, the lowest frequency of the measurement position in each frequency range should be set at the lowest boundary of the frequency range plus MBW/2. The highest frequency of the measurement position in each frequency range should be set at the highest boundary of the frequency range minus MBW/2. MBW denotes the measurement bandwidth defined for the protected band.

**Table 6.5A.3.1.1.5-1: Spurious emissions for CA test requirements**

Frequency Range	Maximum Level	Measurement bandwidth	NOTE
6 GHz ≤ f < 12.75 GHz	-30 dBm	1 MHz	
12.75 GHz ≤ f ≤ 2 <sup>nd</sup> harmonic of the upper frequency edge of the UL operating band in GHz	-13 dBm	1 MHz	
NOTE 1: Applies for Band n257, n258, n260			

6.5A.3.1.2 General spurious emissions for CA (3UL CA)

Editor’s note: The following aspects are either missing or not yet determined:

- The testability of this test case is pending further analysis on relaxation of the requirement for band other than n257, n258, n260 and n261.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2, and 4.
- Connection diagram between SS and UE in TS 38.508-1 [10] Annex A is FFS.
- Test procedure only includes the testing of smartphone and is FFS for laptop and FWA.

6.5A.3.1.2.1 Test purpose

To verify that UE transmitter does not cause unacceptable interference to other channels or other systems in terms of transmitter spurious emissions.

6.5A.3.1.2.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 3UL CA.

6.5A.3.1.2.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.5A.3.1.0.

#### 6.5A.3.1.2.4 Test description

Same test description as in clause 6.5A.3.1.1.4.

#### 6.5A.3.1.2.5 Test Requirements

The test requirement is the same as in clause 6.5A.3.1.1.5.

### 6.5A.3.1.3 General spurious emissions for CA (4UL CA)

**Editor's note:** The following aspects are either missing or not yet determined:

- The testability of this test case is pending further analysis on relaxation of the requirement for band other than n257, n258, n260 and n261.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2, and 4.
- Connection diagram between SS and UE in TS 38.508-1 [10] Annex A is FFS.
- Test procedure only includes the testing of smartphone and is FFS for laptop and FWA.

#### 6.5A.3.1.3.1 Test purpose

To verify that UE transmitter does not cause unacceptable interference to other channels or other systems in terms of transmitter spurious emissions.

#### 6.5A.3.1.3.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 4UL CA.

#### 6.5A.3.1.3.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.5A.3.1.0.

#### 6.5A.3.1.3.4 Test description

Same test description as in clause 6.5A.3.1.1.4.

#### 6.5A.3.1.3.5 Test Requirements

The test requirement is the same as in clause 6.5A.3.1.1.5.

### 6.5A.3.1.4 General spurious emissions for CA (5UL CA)

**Editor's note:** The following aspects are either missing or not yet determined:

- The testability of this test case is pending further analysis on relaxation of the requirement for band other than n257, n258, n260 and n261.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2, and 4.
- Connection diagram between SS and UE in TS 38.508-1 [10] Annex A is FFS.
- Test procedure only includes the testing of smartphone and is FFS for laptop and FWA.

#### 6.5A.3.1.4.1 Test purpose

To verify that UE transmitter does not cause unacceptable interference to other channels or other systems in terms of transmitter spurious emissions.

#### 6.5A.3.1.4.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 5UL CA.

#### 6.5A.3.1.4.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.5A.3.1.0.

#### 6.5A.3.1.4.4 Test description

Same test description as in clause 6.5A.3.1.1.4.

#### 6.5A.3.1.4.5 Test Requirements

The test requirement is the same as in clause 6.5A.3.1.1.5

### 6.5A.3.1.5 General spurious emissions for CA (6UL CA)

*Editor's note: The following aspects are either missing or not yet determined:*

- *The testability of this test case is pending further analysis on relaxation of the requirement for band other than n257, n258, n260 and n261.*
- *Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2, and 4.*
- *Connection diagram between SS and UE in TS 38.508-1 [10] Annex A is FFS.*
- *Test procedure only includes the testing of smartphone and is FFS for laptop and FWA.*

#### 6.5A.3.1.5.1 Test purpose

To verify that UE transmitter does not cause unacceptable interference to other channels or other systems in terms of transmitter spurious emissions.

#### 6.5A.3.1.5.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 6UL CA.

#### 6.5A.3.1.5.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.5A.3.1.0.

#### 6.5A.3.1.5.4 Test description

Same test description as in clause 6.5A.3.1.1.4.

#### 6.5A.3.1.5.5 Test Requirements

The test requirement is the same as in clause 6.5A.3.1.1.5

### 6.5A.3.1.6 General spurious emissions for CA (7UL CA)

*Editor's note: The following aspects are either missing or not yet determined:*

- *The testability of this test case is pending further analysis on relaxation of the requirement for band other than n257, n258, n260 and n261.*
- *Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2, and 4.*
- *Connection diagram between SS and UE in TS 38.508-1 [10] Annex A is FFS.*
- *Test procedure only includes the testing of smartphone and is FFS for laptop and FWA.*

#### 6.5A.3.1.6.1 Test purpose

To verify that UE transmitter does not cause unacceptable interference to other channels or other systems in terms of transmitter spurious emissions.

#### 6.5A.3.1.6.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 7UL CA.

#### 6.5A.3.1.6.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.5A.3.1.0.

#### 6.5A.3.1.6.4 Test description

Same test description as in clause 6.5A.3.1.1.4.

#### 6.5A.3.1.6.5 Test Requirements

The test requirement is the same as in clause 6.5A.3.1.1.5

### 6.5A.3.1.7 General spurious emissions for CA (8UL CA)

**Editor's note: The following aspects are either missing or not yet determined:**

- The testability of this test case is pending further analysis on relaxation of the requirement for band other than n257, n258, n260 and n261.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2, and 4.
- Connection diagram between SS and UE in TS 38.508-1 [10] Annex A is FFS.
- Test procedure only includes the testing of smartphone and is FFS for laptop and FWA.

#### 6.5A.3.1.7.1 Test purpose

To verify that UE transmitter does not cause unacceptable interference to other channels or other systems in terms of transmitter spurious emissions.

#### 6.5A.3.1.7.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 8UL CA.

#### 6.5A.3.1.7.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.5A.3.1.0.

#### 6.5A.3.1.7.4 Test description

Same test description as in clause 6.5A.3.1.1.4.

#### 6.5A.3.1.7.5 Test Requirements

The test requirement is the same as in clause 6.5A.3.1.1.5

### 6.5A.3.2 Spurious emission band UE co-existence for UL CA

This clause specifies the requirements for the specified carrier aggregation configurations for coexistence with protected bands. The requirement is verified in beam locked mode with the test metric of TRP (Link=TX beam peak direction, Meas=TRP grid). The TX beam peak direction used for CA testing is the [same as that found for single carrier scenario in clause 6.5.3].

**NOTE:** For measurement conditions at the edge of each frequency range, the lowest frequency of the measurement position in each frequency range should be set at the lowest boundary of the frequency range plus MBW/2. The highest frequency of the measurement position in each frequency range should be set at the highest boundary of the frequency range minus MBW/2. MBW denotes the measurement bandwidth defined for the protected band.

## 6.5A.3.2.0 Minimum conformance requirements

For intra-band contiguous carrier aggregation, the requirements in Table 6.5A.3.2.0-1 apply.

**Table 6.5A.3.2.0-1: Spurious emissions UE co-existence CA limits**

CA band	Spurious emission						
	Protected band / frequency range	Frequency range (MHz)			Maximum Level (dBm)	MBW (MHz)	NOTE
CA_n257	NR Band n260	F <sub>DL_low</sub>	-	F <sub>DL_high</sub>	-2	100	
	Frequency range	23600	-	24000	1	200	2
	Frequency range	57000	-	66000	2	100	
CA_n258							
	Frequency range	57000	-	66000	2	100	
CA_n259	NR Band 257	F <sub>DL_low</sub>	-	F <sub>DL_high</sub>	-5	100	
	NR Band 261	F <sub>DL_low</sub>	-	F <sub>DL_high</sub>	-5	100	
	Frequency range	36000	-	37000	7	1000	
	Frequency range	57000	-	66000	2	100	
CA_n260	NR Band 257	F <sub>DL_low</sub>	-	F <sub>DL_high</sub>	-5	100	
	NR Band 261	F <sub>DL_low</sub>	-	F <sub>DL_high</sub>	-5	100	
	Frequency range	57000	-	66000	2	100	
CA_n261	NR Band 260	F <sub>DL_low</sub>	-	F <sub>DL_high</sub>	-2	100	
	Frequency range	57000	-	66000	2	100	

NOTE 1: F<sub>DL\_low</sub> and F<sub>DL\_high</sub> refer to each NR frequency band specified in Table 5.2-1  
NOTE 2: The protection of frequency range 23600-24000MHz is meant for protection of satellite passive services.

## 6.5A.3.2.1 Spurious emission band UE co-existence for CA (2UL CA)

Editor's note: The following aspects are either missing or not yet determined:

- The testability of this test case is pending further analysis on relaxation of the requirement for band other than n257, n258, n260 and n261.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2, and 4.
- Connection diagram between SS and UE in TS 38.508-1 [10] Annex A is FFS.
- Test procedure only includes the testing of smartphone and is FFS for laptop and FWA.
- For a transition period until RAN#99, the stability and repeatability of test procedure with PHR (variant b) for Rel-15 UEs is under evaluation.

## 6.5A.3.2.1.1 Test purpose

To verify that UE transmitter does not cause unacceptable interference when in co-existence with protected bands in terms of transmitter spurious emissions.

## 6.5A.3.2.1.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 2UL CA.

## 6.5A.3.2.1.3 Minimum conformance requirements

Same minimum conformance requirements as in clause 6.5A.3.2.0.

6.5A.3.2.1.4 Test description

6.5A.3.2.1.4.1 Initial conditions

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, and channel bandwidths based on NR operating bands specified in clause 5.5A. All of these configurations shall be tested with applicable test parameters for each channel bandwidth and subcarrier spacing, are shown in Table 6.5A.3.2.1.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.5A.3.2.1.4.1-1: Test Configuration Table**

Initial Conditions				
Test Environment as specified in TS 38.508-1 [10] subclause 4.1		Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes		Low range, High range (NOTE 2)		
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.		Maximum aggregated BW (contiguous CA)		
Test SCS as specified in Table 5.3.5-1		120kHz		
Test Parameters				
Test ID	CC	Downlink Configuration	UL Modulation	UL RB allocation (NOTE 1)
1	PCC	-	DFT-s-OFDM QPSK	Outer_Full
	SCCs		DFT-s-OFDM QPSK	Outer_Full
2	PCC		DFT-s-OFDM QPSK	Inner_1RB for PC2, PC3 and PC4 Inner_Partial for PC1 (NOTE 3)
	SCCs		DFT-s-OFDM QPSK	Inner_1RB for PC2, PC3 and PC4 Inner_Partial for PC1
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.				
NOTE 2: When testing Low range test only in Frequency Range lower than $(F_{UL\_low} - \Delta f_{OOB})$ and when testing High range test only in Frequency Range higher than $(F_{UL\_high} + \Delta f_{OOB})$ .				
NOTE 3: When testing Low range configure uplink RB to Inner_1RB_Left for PC2, PC3 and PC4 or Inner_Partial_Left_Region1 for PC1 and when testing High range configure uplink RB to Inner_1RB_Right for PC2, PC3 and PC4 or Inner_Partial_Right_Region1 for PC1.				
NOTE 4: For a FR2 band under test, if the protected band frequency range in Table 6.5A.3.2.0-1 is only on lower or only higher frequency region with respect to the FR2 band under test then it is sufficient to test only Low range or High range frequencies, otherwise test at both Low range and High range.				
NOTE 5: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".				

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure [TBD] for TE diagram and Figure [TBD] for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement channels are set according to Table 6.5A.3.2.1.4.1-1.
5. Propagation conditions are set according to Annex B.0.

6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.5A.3.2.1.4.3.

#### 6.5A.3.2.1.4.2 Test procedure

1. Select any of the three Alignment Options (1, 2, or 3) from Tables N.2-1 through N.2-3 to mount the DUT inside the QZ.
2. If the re-positioning concept is applied, position the device in DUT Orientation 1 if the maximum beam peak direction is within zenith angular range  $0^\circ \leq \theta \leq 90^\circ$  for the alignment option selected in step 1; position the device in DUT Orientation 2 (either Options 1 or 2) if the maximum beam peak direction is within zenith angular range  $90^\circ < \theta \leq 180^\circ$  for DUT Orientation 1 for the alignment option selected in step 1. If the re-positioning concept is not applied, position the device in DUT Orientation 1.
3. Configure SCC according to Annex C.0, C.1, C.2 for all downlink physical channels.
4. The SS shall configure SCC as per TS 38.508-1 [10] clause 5.5.1. Message contents are defined in clause 6.5A.3.2.1.4.3.
5. Apply the test step based on the 5G NR UE Release:
  - 5a. For Release 16 and forward 5G NR UEs: SS applies a backoff on the PCell power by activating the UE Power Limit Function (UPLF). The ACTIVATE POWER LIMIT REQUEST procedure is performed as specified in TS 38.508-1 [10] clause 4.9.32 using condition 'NR FR2 2CA'. UE shall transmit ACTIVATE POWER LIMIT RESPONSE to SS. Go to step 6.
  - 5b. For Release 15 5G NR UEs: No action.
6. SS activates SCC by sending the activation MAC CE (Refer TS 38.321 [28], clauses 5.9, 6.1.3.10). Wait for at least 2 seconds (Refer TS 38.133[25], clause 9.3).
7. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.5A.3.2.1.4.1-1. Since the UL has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC.
8. Set the UE in the Inband Tx beam peak direction [(same as that found for single carrier in clause 6.5.3)] found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 3) for the UE Tx beam selection to complete.
9. Apply the test step based on the 5G NR UE Release:
  - 9a. For Release 16 and forward 5G NR UEs: Send continuously uplink power control "up" commands in every uplink scheduling information to the UE; allow at least 200msec for the UE to reach  $P_{UMAX}$ . Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 3) for the UE Tx beam selection to complete.
  - 9b. For Release 15 5G NR UEs: Send uplink power control commands in uplink scheduling information to the UE per UL CC until the Power Headroom Report (PHR) from the UE for each UL CC is at the target value according to Table 6.2A.2.1.4.2-1; allow at least 200 ms for the UE to reach maximum output power. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
10. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
11. Measure the spurious emissions as per steps outlined below with an exception to the procedure in Annex K if the re-positioning concept is applied (NOTE 4):
  - (a) Perform coarse TRP measurements to identify spurious emission frequencies and corresponding power level according to the procedures in Annex L, using coarse TRP measurement grid selection criteria as per Table M.4.5-3 in Annex M. The measurement is completed in both polarizations  $\theta$  and  $\phi$  over frequency range and measurement bandwidth according to Table 6.5A.3.2.1.5-1. Optionally, a larger and non-constant measurement bandwidth than that of Table 6.5A.3.2.1.5-1 may be applied as long as the SNR (ratio of test limit to floor noise of test equipment)  $\geq 10$ dB is guaranteed. The measurement period shall capture the [active time slots]. For each spurious emission frequency with coarse TRP identified to be less than an offset



dB (NOTE 2) from the TRP limit according to Table 6.5A.3.2.1.5-1, continue with fine TRP procedures according to step (b).

The offset value shall be the TRP measurement uncertainty at 95% confidence level including the effect of coarse grid measurement uncertainty element. Different coarse TRP grids and corresponding offset values may be used for different frequencies. The coarse TRP grid and offset values used shall be recorded in the test report.

(b) Measure fine TRP measurements according to procedures in Annex K, using fine TRP measurement grid selection criteria as per Table M.4.5-3 in Annex M, for each of the spurious emission frequency identified in step (a). Apply a measurement bandwidth according to Table 6.5A.3.2.1.5-1.

12. Apply the test step based on the 5G NR UE Release:

12a. For Release 16 and forward 5G NR UEs: SS deactivates the UE Power Limit Function (UPLF) by performing the DEACTIVATE POWER LIMIT REQUEST procedure as specified in TS 38.508-1 [10] clause 4.9.33.

12b. For Release 15 5G NR UEs: No action.

13. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

NOTE 1: The frequency range defined in Table 6.5A.3.2.1.5-1 may be split into ranges. For each range a different test system, e.g. antenna and/or chamber, may be used. To pass the test case all verdicts of the frequency ranges must pass.

NOTE 2: The coarse TRP measurement grid and corresponding offset dB value referred in step 10(a) above, for some valid grids can be found in TR 38.903 section B.18.

NOTE 3: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

NOTE 4: If the (in-band) beam peak is within  $0^\circ \leq \theta \leq 90^\circ$ : perform first hemispherical TRP scan ( $0^\circ \leq \theta \leq 90^\circ$ ) in DUT Orientation 1 and second hemispherical TRP scan ( $90^\circ > \theta \geq 0^\circ$ ) in DUT Orientation 2. If the (in-band) beam peak is within  $90^\circ < \theta \leq 180^\circ$ : perform first hemispherical TRP scan ( $0^\circ \leq \theta \leq 90^\circ$ ) in DUT Orientation 2 and second hemispherical TRP scan ( $90^\circ > \theta \geq 0^\circ$ ) in DUT Orientation 1. The DUT with UBF activated needs to be re-positioned during the test.

#### 6.5A.3.2.1.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6.1 with the following exceptions for Release 15 5G NR UE.

**Table 6.5A.3.2.1.4.3-1: PUSCH-PowerControl**

Derivation Path: TS 38.508-1 [10], Table 4.6.3-120			
Information Element	Value/remark	Comment	Condition
PUSCH-PowerControl ::= SEQUENCE {			
tpc-Accumulation	disabled		
p0-AlphaSets SEQUENCE (SIZE (1..maxNrofP0-PUSCH-AlphaSets)) OF SEQUENCE {	1 entry		
P0-PUSCH-AlphaSet[1] SEQUENCE {			
alpha	alpha0		
}			
}			
}			

#### 6.5A.3.2.1.5 Test requirement

This clause specifies the requirements for the specified NR band for Transmitter Spurious emissions for UE co-existence requirement with frequency range as indicated in Table 6.5A.3.2.1.5-1.

The maximum TRP power of spurious emission for UE co-existence, measured using RMS detector, shall not exceed the described value in Table 6.5A.3.2.1.5-1.

The spurious emission UE co-existence limits in Table 6.5A.3.2.1.5-1 apply for all transmitter band configurations (NRB) and channel bandwidths.

NOTE: For measurement conditions at the edge of each frequency range, the lowest frequency of the measurement position in each frequency range should be set at the lowest boundary of the frequency range plus MBW/2. The highest frequency of the measurement position in each frequency range should be set at the highest boundary of the frequency range minus MBW/2. MBW denotes the measurement bandwidth defined for the protected band.

**Table 6.5A.3.2.1.5-1: Spurious emissions UE co-existence CA test requirements**

UL CA for any CA bandwidth class	Spurious emission						
	Protected band / frequency range	Frequency range (MHz)			Maximum Level (dBm)	MBW (MHz)	NOTE
CA_n257	NR Band n260	F <sub>DL_low</sub>	-	F <sub>DL_high</sub>	-2	100	
	Frequency range	23600	-	24000	1	200	2
	Frequency range	57000	-	66000	2	100	
CA_n258	Frequency range	57000	-	66000	2	100	
CA_n259	NR Band 257	F <sub>DL_low</sub>	-	F <sub>DL_high</sub>	-5	100	
	NR Band 261	F <sub>DL_low</sub>	-	F <sub>DL_high</sub>	-5	100	
	Frequency range	36000	-	37000	7	1000	
	Frequency range	57000	-	66000	2	100	
CA_n260	NR Band 257	F <sub>DL_low</sub>	-	F <sub>DL_high</sub>	-5	100	
	NR Band 261	F <sub>DL_low</sub>	-	F <sub>DL_high</sub>	-5	100	
	Frequency range	57000	-	66000	2	100	
CA_n261	NR Band 260	F <sub>DL_low</sub>	-	F <sub>DL_high</sub>	-2	100	
	Frequency range	57000	-	66000	2	100	

NOTE 1: F<sub>DL\_low</sub> and F<sub>DL\_high</sub> refer to each NR frequency band specified in Table 5.2-1  
NOTE 2: The protection of frequency range 23600-2400MHz is meant for protection of satellite passive services.

### 6.5A.3.2.2 Spurious emission band UE co-existence for CA (3UL CA)

Editor's note: The following aspects are either missing or not yet determined:

- The testability of this test case is pending further analysis on relaxation of the requirement for band other than n257, n258, n260 and n261.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2, and 4.
- Connection diagram between SS and UE in TS 38.508-1 [10] Annex A is FFS.
- Test procedure only includes the testing of smartphone and is FFS for laptop and FWA.

#### 6.5A.3.2.2.1 Test purpose

To verify that UE transmitter does not cause unacceptable interference when in co-existence with protected bands in terms of transmitter spurious emissions.

#### 6.5A.3.2.2.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 3UL CA.

#### 6.5A.3.2.2.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.5A.3.2.0.

#### 6.5A.3.2.2.4 Test description

Same test description as in clause 6.5A.3.2.1.4.

#### 6.5A.3.2.2.5 Test Requirements

The test requirement is the same as in clause 6.5A.3.2.1.5.

### 6.5A.3.2.3 Spurious emission band UE co-existence for CA (4UL CA)

**Editor's note:** The following aspects are either missing or not yet determined:

- The testability of this test case is pending further analysis on relaxation of the requirement for band other than n257, n258, n260 and n261.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2, and 4.
- Connection diagram between SS and UE in TS 38.508-1 [10] Annex A is FFS.
- Test procedure only includes the testing of smartphone and is FFS for laptop and FWA.

#### 6.5A.3.2.3.1 Test purpose

To verify that UE transmitter does not cause unacceptable interference when in co-existence with protected bands in terms of transmitter spurious emissions.

#### 6.5A.3.2.3.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 4UL CA.

#### 6.5A.3.2.3.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.5A.3.2.0.

#### 6.5A.3.2.3.4 Test description

Same test description as in clause 6.5A.3.2.1.4.

#### 6.5A.3.2.3.5 Test Requirements

The test requirement is the same as in clause 6.5A.3.2.1.5.

### 6.5A.3.2.4 Spurious emission band UE co-existence for CA (5UL CA)

**Editor's note:** The following aspects are either missing or not yet determined:

- The testability of this test case is pending further analysis on relaxation of the requirement for band other than n257, n258, n260 and n261.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2, and 4.
- Connection diagram between SS and UE in TS 38.508-1 [10] Annex A is FFS.
- Test procedure only includes the testing of smartphone and is FFS for laptop and FWA.

#### 6.5A.3.2.4.1 Test purpose

To verify that UE transmitter does not cause unacceptable interference when in co-existence with protected bands in terms of transmitter spurious emissions.

#### 6.5A.3.2.4.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 5UL CA.

#### 6.5A.3.2.4.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.5A.3.2.0.

#### 6.5A.3.2.4.4 Test description

Same test description as in clause 6.5A.3.2.1.4.

#### 6.5A.3.2.4.5 Test Requirements

The test requirement is the same as in clause 6.5A.3.2.1.5.

### 6.5A.3.2.5 Spurious emission band UE co-existence for CA (6UL CA)

*Editor's note: The following aspects are either missing or not yet determined:*

- *The testability of this test case is pending further analysis on relaxation of the requirement for band other than n257, n258, n260 and n261.*
- *Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2, and 4.*
- *Connection diagram between SS and UE in TS 38.508-1 [10] Annex A is FFS.*
- *Test procedure only includes the testing of smartphone and is FFS for laptop and FWA.*

#### 6.5A.3.2.5.1 Test purpose

To verify that UE transmitter does not cause unacceptable interference when in co-existence with protected bands in terms of transmitter spurious emissions.

#### 6.5A.3.2.5.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 6UL CA.

#### 6.5A.3.2.5.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.5A.3.2.0.

#### 6.5A.3.2.5.4 Test description

Same test description as in clause 6.5A.3.2.1.4.

#### 6.5A.3.2.5.5 Test Requirements

The test requirement is the same as in clause 6.5A.3.2.1.5.

### 6.5A.3.2.6 Spurious emission band UE co-existence for CA (7UL CA)

*Editor's note: The following aspects are either missing or not yet determined:*

- *The testability of this test case is pending further analysis on relaxation of the requirement for band other than n257, n258, n260 and n261.*
- *Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2, and 4.*
- *Connection diagram between SS and UE in TS 38.508-1 [10] Annex A is FFS.*
- *Test procedure only includes the testing of smartphone and is FFS for laptop and FWA.*

#### 6.5A.3.2.6.1 Test purpose

To verify that UE transmitter does not cause unacceptable interference when in co-existence with protected bands in terms of transmitter spurious emissions.

#### 6.5A.3.2.6.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 7UL CA.

#### 6.5A.3.2.6.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.5A.3.2.0.

#### 6.5A.3.2.6.4 Test description

Same test description as in clause 6.5A.3.2.1.4.

#### 6.5A.3.2.6.5 Test Requirements

The test requirement is the same as in clause 6.5A.3.2.1.5.

#### 6.5A.3.2.7 Spurious emission band UE co-existence for CA (8UL CA)

**Editor's note: The following aspects are either missing or not yet determined:**

- The testability of this test case is pending further analysis on relaxation of the requirement for band other than n257, n258, n260 and n261.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2, and 4.
- Connection diagram between SS and UE in TS 38.508-1 [10] Annex A is FFS.
- Test procedure only includes the testing of smartphone and is FFS for laptop and FWA.

#### 6.5A.3.2.7.1 Test purpose

To verify that UE transmitter does not cause unacceptable interference when in co-existence with protected bands in terms of transmitter spurious emissions.

#### 6.5A.3.2.7.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 8UL CA.

#### 6.5A.3.2.7.3 Minimum conformance requirements

The minimum conformance requirements are defined in clause 6.5A.3.2.0.

#### 6.5A.3.2.7.4 Test description

Same test description as in clause 6.5A.3.2.1.4.

#### 6.5A.3.2.7.5 Test Requirements

The test requirement is the same as in clause 6.5A.3.2.1.5.

#### 6.5A.3.3 Additional spurious emissions for CA

##### 6.5A.3.3.0 Minimum conformance requirements

The additional spurious emission for CA limits in Table 6.5A.3.3.0-2 and Table 6.5A.3.3.0-3 apply for all transmitter band configurations (RB) and channel bandwidths. The requirement is verified in beam locked mode with the test metric of TRP (Link=TX beam peak direction, Meas=TRP grid).

NOTE: For measurement conditions at the edge of each frequency range, the lowest frequency of the measurement position in each frequency range should be set at the lowest boundary of the frequency range plus MBW/2. The highest frequency of the measurement position in each frequency range should be set at the highest boundary of the frequency range minus MBW/2. MBW denotes the measurement bandwidth defined for the protected band.

**Table 6.5A.3.3.0-1: Void**

When "CA\_NS\_202" is indicated in the cell, the power of any UE emission shall not exceed the levels specified in Table 6.5A.3.3.0-2.

**Table 6.5A.3.3.0-2: Additional spurious emissions for (CA\_NS\_202) test limits**

Frequency Range	Maximum Level	Measurement bandwidth
$7.25 \text{ GHz} \leq f \leq 2^{\text{nd}}$ harmonic of the upper frequency edge of the UL operating band	-10 dBm	100 MHz
$23.6 \text{ GHz} \leq f \leq 24.0 \text{ GHz}$	+1 dBm	200 MHz

When "CA\_NS\_203" is indicated in the cell, the power of any UE emission shall not exceed the levels specified in Table 6.5A.3.3.0-3. This requirement also applies for the frequency ranges that are less than  $F_{\text{OOB}}$  (MHz) in Table 6.5A.3.2.0-1 from the edge of the channel bandwidth.

**Table 6.5A.3.3.0-3: Additional spurious emissions (CA\_NS\_203) test limits**

Frequency band (GHz)	Spectrum emission limit (dBm)	Measurement bandwidth
$23.6 \leq f \leq 24.0$	+1	200 MHz

The normative reference for this requirement is TS 38.101-2 subclause 6.5A.3.2.

### 6.5A.3.3.1 Additional spurious emissions for CA (2UL CA)

**Editor's note:** This clause is incomplete. The following aspects are either missing or not yet determined:

- The testability of this test case is pending further analysis on relaxation of the requirement for band other than n257, n258, n260 and n261.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2, and 4.
- TP analysis for CA is FFS (identify lowest MPR w/form, RB allocation for multiple carrier or PCC only, IRB location if RB allocated for multiple carrier).
- Connection diagram between SS and UE in TS 38.508-1 [10] Annex A is FFS.
- Test procedure only includes the testing of smartphone and is FFS for laptop and FWA.
- For a transition period until RAN#99, the stability and repeatability of test procedure with PHR (variant b) for Rel-15 UEs is under evaluation.

#### 6.5A.3.3.1.1 Test purpose

Additional spurious emission requirements are signalled by the network to indicate that the UE shall meet an additional requirement for a specific deployment scenario as part of the cell handover/broadcast message.

#### 6.5A.3.3.1.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 2UL CA.

6.5A.3.3.1.3 Minimum conformance requirements

Same minimum conformance requirements as in clause 6.5A.3.3.0.

6.5A.3.3.1.4 Test description

6.5A.3.3.1.4.1 Initial conditions

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, and channel bandwidths based on NR operating bands specified in clause 5.5A. All of these configurations shall be tested with applicable test parameters for each channel bandwidth and subcarrier spacing, are shown in Table 6.5A.3.3.1.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.5A.3.3.1.4.1-1: Test Configuration Table**

Initial Conditions			
Test Environment as specified in TS 38.508-1 [10] subclause 4.1		Normal	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for different CA bandwidth classes		Low range, High range (NOTE 2)	
Test CC combination setting as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 for the CA Configuration across bandwidth combination sets supported by the UE.		Highest	
Test SCS as specified in Table 5.3.5-1		120kHz	
Test Parameters			
Test ID	Downlink Configuration	Uplink Configuration	
		Modulation	RB allocation (NOTE 1)
1	-	FFS	FFS
2		FFS	FFS
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.			
NOTE 2: When testing Low range test only in Frequency Range lower than ( $F_{UL\_low} - \Delta f_{OOB}$ ) and when testing High range test only in Frequency Range higher than ( $F_{UL\_high} + \Delta f_{OOB}$ ).			
NOTE 3: Number of DL CCs shall be configured the same as number of UL CCs. The requirements are applicable as per 5.3A.4: "The requirements are applicable only when Uplink CCs are configured within the frequency range between lower edge of lowest downlink component carrier and upper edge of highest downlink component carrier".			

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure [TBD] for TE diagram and Figure [TBD] for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement channels are set according to Table 6.5A.3.3.1.4.1-1.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity NR, Connected without release On, Test Mode On and Test Loop Function On according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.5A.3.3.1.4.3.

6.5A.3.3.1.4.2 Test procedure

1. Select any of the three Alignment Options (1, 2, or 3) from Tables N.2-1 through N.2-3 to mount the DUT inside the QZ.

2. If the re-positioning concept is applied, position the device in DUT Orientation 1 if the maximum beam peak direction is within zenith angular range  $0^\circ \leq \theta \leq 90^\circ$  for the alignment option selected in step 1; position the device in DUT Orientation 2 (either Options 1 or 2) if the maximum beam peak direction is within zenith angular range  $90^\circ < \theta \leq 180^\circ$  for DUT Orientation 1 for the alignment option selected in step 1. If the re-positioning concept is not applied, position the device in DUT Orientation 1.
3. Configure SCC according to Annex C.0, C.1, C.2 for all downlink physical channels.
4. The SS shall configure SCC as per TS 38.508-1 [10] clause 5.5.1. Message contents are defined in clause 6.5A.3.3.1.4.3.
5. Apply the test step based on the 5G NR UE Release:
  - 5a. For Release 16 and forward 5G NR UEs: SS applies a backoff on the PCell power by activating the UE Power Limit Function (UPLF). The ACTIVATE POWER LIMIT REQUEST procedure is performed as specified in TS 38.508-1 [10] clause 4.9.32 using condition 'NR FR2 2CA'. UE shall transmit ACTIVATE POWER LIMIT RESPONSE to SS. Go to step 6.
  - 5b. For Release 15 5G NR UEs: No action.
6. SS activates SCC by sending the activation MAC CE (Refer TS 38.321 [28], clauses 5.9, 6.1.3.10). Wait for at least 2 seconds (Refer TS 38.133[25], clause 9.3).
7. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.5A.3.3.1.4.1-1. Since the UL has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC.
8. Set the UE in the Inband Tx beam peak direction [(same as that found for single carrier in clause 6.5.3)] found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 3) for the UE Tx beam selection to complete.
9. Apply the test step based on the 5G NR UE Release:
  - 9a. For Release 16 and forward 5G NR UEs: Send continuously uplink power control "up" commands in every uplink scheduling information to the UE; allow at least 200msec for the UE to reach  $P_{UMAX}$ . Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 3) for the UE Tx beam selection to complete.
  - 9b. For Release 15 5G NR UEs: Send uplink power control commands in uplink scheduling information to the UE per UL CC until the Power Headroom Report (PHR) from the UE for each UL CC is at the target value according to Table 6.2A.2.1.4.2-1; allow at least 200 ms for the UE to reach maximum output power. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
10. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
11. Measure the spurious emissions as per steps outlined below with an exception to the procedure in Annex K if the re-positioning concept is applied (NOTE 4):
  - (a) Perform coarse TRP measurements to identify spurious emission frequencies and corresponding power level according to the procedures in Annex L, using coarse TRP measurement grid selection criteria as per Table M.4.5-3 in Annex M. The measurement is completed in both polarizations  $\theta$  and  $\phi$  over frequency range and measurement bandwidth according to Table 6.5A.3.3.1.5-2. Optionally, a larger and non-constant measurement bandwidth than that of Table 6.5A.3.3.1.5-2 may be applied as long as the SNR (ratio of test limit to floor noise of test equipment)  $\geq 10$ dB is guaranteed. The measurement period shall capture the [active time slots]. For each spurious emission frequency with coarse TRP identified to be less than an offset dB (NOTE 2) from the TRP limit according to Table 6.5A.3.3.1.5-2, continue with fine TRP procedures according to step (b).

The offset value shall be the TRP measurement uncertainty at 95% confidence level including the effect of coarse grid measurement uncertainty element. Different coarse TRP grids and corresponding offset values may be used for different frequencies. The coarse TRP grid and offset values used shall be recorded in the test report.



(b) Measure fine TRP measurements according to procedures in Annex K, using fine TRP measurement grid selection criteria as per Table M.4.5-3 in Annex M, for each of the spurious emission frequency identified in step (a). Apply a measurement bandwidth according to Table 6.5A.3.3.1.5-2.

12. Apply the test step based on the 5G NR UE Release:

12a. For Release 16 and forward 5G NR UEs: SS deactivates the UE Power Limit Function (UPLF) by performing the DEACTIVATE POWER LIMIT REQUEST procedure as specified in TS 38.508-1 [10] clause 4.9.33.

12b. For Release 15 5G NR UEs: No action.

13. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

NOTE 1: The frequency range defined in Table 6.5A.3.3.1.5-2 may be split into ranges. For each range a different test system, e.g. antenna and/or chamber, may be used. To pass the test case all verdicts of the frequency ranges must pass.

NOTE 2: The coarse TRP measurement grid and corresponding offset dB value referred in step 10(a) above, for some valid grids can be found in TR 38.903 section B.18.

NOTE 3: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

NOTE 4: If the (in-band) beam peak is within  $0^\circ \leq \theta \leq 90^\circ$ : perform first hemispherical TRP scan ( $0^\circ \leq \theta \leq 90^\circ$ ) in DUT Orientation 1 and second hemispherical TRP scan ( $90^\circ > \theta \geq 0^\circ$ ) in DUT Orientation 2. If the (in-band) beam peak is within  $90^\circ < \theta \leq 180^\circ$ : perform first hemispherical TRP scan ( $0^\circ \leq \theta \leq 90^\circ$ ) in DUT Orientation 2 and second hemispherical TRP scan ( $90^\circ > \theta \geq 0^\circ$ ) in DUT Orientation 1. The DUT with UBF activated needs to be re-positioned during the test.

6.5A.3.3.1.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6.1 with the following exceptions for Release 15 5G NR UE.

**Table 6.5A.3.3.1.4.3-1: PUSCH-PowerControl**

Derivation Path: TS 38.508-1 [10], Table 4.6.3-120			
Information Element	Value/remark	Comment	Condition
PUSCH-PowerControl ::= SEQUENCE {			
tpc-Accumulation	disabled		
p0-AlphaSets SEQUENCE (SIZE (1..maxNrofP0-PUSCH-AlphaSets)) OF SEQUENCE {	1 entry		
P0-PUSCH-AlphaSet[1] SEQUENCE {			
alpha	alpha0		
}			
}			
}			

6.5A.3.3.1.5 Test requirement

This clause specifies the requirements for the specified NR band for Transmitter Spurious emissions for UE co-existence requirement with frequency range as indicated in Table 6.5A.3.3.1.5-2.

The maximum TRP power of spurious emission for UE co-existence, measured using RMS detector, shall not exceed the described value in Table 6.5A.3.3.1.5-2.

The additional spurious emission for CA limits in Table 6.5A.3.3.1.5-2 apply for all transmitter band configurations (NRB) and channel bandwidths.

NOTE: For measurement conditions at the edge of each frequency range, the lowest frequency of the measurement position in each frequency range should be set at the lowest boundary of the frequency range plus MBW/2. The highest frequency of the measurement position in each frequency range should be set at the highest boundary of the frequency range minus MBW/2. MBW denotes the measurement bandwidth defined for the protected band.

**Table 6.5A.3.3.1.5-1: Void**

**Table 6.5A.3.3.1.5-2: Additional spurious emissions for CA (CA\_NS\_202) test requirements**

Frequency Range	Maximum Level	Measurement bandwidth
7.25 GHz ≤ f ≤ 2 <sup>nd</sup> harmonic of the upper frequency edge of the UL operating band	-10 dBm	100 MHz
23.6 GHz ≤ f ≤ 24.0 GHz	+1 dBm	200 MHz
23.6 GHz ≤ f ≤ 24.0 GHz	+1 dBm	200 MHz

**Table 6.5A.3.3.1.5-3: Additional spurious emissions for CA (CA\_NS\_203) test limits**

Frequency band (GHz)	Spectrum emission limit (dBm)	Measurement bandwidth
23.6 ≤ f ≤ 24.0	+1	200 MHz

**6.5A.3.3.2 Additional spurious emissions for CA (3UL CA)**

Editor’s note: This clause is incomplete. The following aspects are either missing or not yet determined:

- The testability of this test case is pending further analysis on relaxation of the requirement for band other than n257, n258, n260 and n261.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2, and 4.
- TP analysis for CA is FFS (identify lowest MPR w/form, RB allocation for multiple carrier or PCC only, 1RB location if RB allocated for multiple carrier).
- Connection diagram between SS and UE in TS 38.508-1 [10] Annex A is FFS.
- Test procedure only includes the testing of smartphone and is FFS for laptop and FWA.

**6.5A.3.3.2.1 Test purpose**

Additional spurious emission requirements are signalled by the network to indicate that the UE shall meet an additional requirement for a specific deployment scenario as part of the cell handover/broadcast message.

**6.5A.3.3.2.2 Test applicability**

This test case applies to all types of NR UE release 15 and forward that supports FR2 3UL CA.

**6.5A.3.3.2.3 Minimum conformance requirements**

Same minimum conformance requirements as in clause 6.5A.3.3.0.

#### 6.5A.3.3.2.4 Test description

Same test description as in clause 6.5A.3.3.1.4.

#### 6.5A.3.3.2.5 Test requirement

The test requirement is the same as in clause 6.5A.3.3.1.5

### 6.5A.3.3.3 Additional spurious emissions for CA (4UL CA)

*Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:*

- *The testability of this test case is pending further analysis on relaxation of the requirement for band other than n257, n258, n260 and n261.*
- *Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2, and 4.*
- *TP analysis for CA is FFS (identify lowest MPR w/form, RB allocation for multiple carrier or PCC only, IRB location if RB allocated for multiple carrier).*
- *Connection diagram between SS and UE in TS 38.508-1 [10] Annex A is FFS.*
- *Test procedure only includes the testing of smartphone and is FFS for laptop and FWA.*

#### 6.5A.3.3.3.1 Test purpose

Additional spurious emission requirements are signalled by the network to indicate that the UE shall meet an additional requirement for a specific deployment scenario as part of the cell handover/broadcast message.

#### 6.5A.3.3.3.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 4UL CA.

#### 6.5A.3.3.3.3 Minimum conformance requirements

Same minimum conformance requirements as in clause 6.5A.3.3.0.

#### 6.5A.3.3.3.4 Test description

Same test description as in clause 6.5A.3.3.1.4.

#### 6.5A.3.3.3.5 Test requirement

The test requirement is the same as in clause 6.5A.3.3.1.5.

### 6.5A.3.3.4 Additional spurious emissions for CA (5UL CA)

*Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:*

- *The testability of this test case is pending further analysis on relaxation of the requirement for band other than n257, n258, n260 and n261.*
- *Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2, and 4.*
- *TP analysis for CA is FFS (identify lowest MPR w/form, RB allocation for multiple carrier or PCC only, IRB location if RB allocated for multiple carrier).*
- *Connection diagram between SS and UE in TS 38.508-1 [10] Annex A is FFS.*
- *Test procedure only includes the testing of smartphone and is FFS for laptop and FWA.*

#### 6.5A.3.3.4.1 Test purpose

Additional spurious emission requirements are signalled by the network to indicate that the UE shall meet an additional requirement for a specific deployment scenario as part of the cell handover/broadcast message.

#### 6.5A.3.3.4.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 5UL CA.

#### 6.5A.3.3.4.3 Minimum conformance requirements

Same minimum conformance requirements as in clause 6.5A.3.3.0.

#### 6.5A.3.3.4.4 Test description

Same test description as in clause 6.5A.3.3.1.4.

#### 6.5A.3.3.4.5 Test requirement

The test requirement is the same as in clause 6.5A.3.3.1.5.

### 6.5A.3.3.5 Additional spurious emissions for CA (6UL CA)

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- The testability of this test case is pending further analysis on relaxation of the requirement for band other than n257, n258, n260 and n261.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2, and 4.
- TP analysis for CA is FFS (identify lowest MPR w/form, RB allocation for multiple carrier or PCC only, 1RB location if RB allocated for multiple carrier).
- Connection diagram between SS and UE in TS 38.508-1 [10] Annex A is FFS.
- Test procedure only includes the testing of smartphone and is FFS for laptop and FWA.

#### 6.5A.3.3.5.1 Test purpose

Additional spurious emission requirements are signalled by the network to indicate that the UE shall meet an additional requirement for a specific deployment scenario as part of the cell handover/broadcast message.

#### 6.5A.3.3.5.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 6UL CA.

#### 6.5A.3.3.5.3 Minimum conformance requirements

Same minimum conformance requirements as in clause 6.5A.3.3.0.

#### 6.5A.3.3.5.4 Test description

Same test description as in clause 6.5A.3.3.1.4.

#### 6.5A.3.3.5.5 Test requirement

The test requirement is the same as in clause 6.5A.3.3.1.5.

### 6.5A.3.3.6 Additional spurious emissions for CA (7UL CA)

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- The testability of this test case is pending further analysis on relaxation of the requirement for band other than n257, n258, n260 and n261.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2, and 4.
- TP analysis for CA is FFS (identify lowest MPR w/form, RB allocation for multiple carrier or PCC only, 1RB location if RB allocated for multiple carrier).
- Connection diagram between SS and UE in TS 38.508-1 [10] Annex A is FFS.
- Test procedure only includes the testing of smartphone and is FFS for laptop and FWA.

#### 6.5A.3.3.6.1 Test purpose

Additional spurious emission requirements are signalled by the network to indicate that the UE shall meet an additional requirement for a specific deployment scenario as part of the cell handover/broadcast message.

#### 6.5A.3.3.6.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 7UL CA.

#### 6.5A.3.3.6.3 Minimum conformance requirements

Same minimum conformance requirements as in clause 6.5A.3.3.0.

#### 6.5A.3.3.6.4 Test description

Same test description as in clause 6.5A.3.3.1.4.

#### 6.5A.3.3.6.5 Test requirement

The test requirement is the same as in clause 6.5A.3.3.1.5.

#### 6.5A.3.3.7 Additional spurious emissions for CA (8UL CA)

Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:

- The testability of this test case is pending further analysis on relaxation of the requirement for band other than n257, n258, n260 and n261.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2, and 4.
- TP analysis for CA is FFS (identify lowest MPR w/form, RB allocation for multiple carrier or PCC only, 1RB location if RB allocated for multiple carrier).
- Connection diagram between SS and UE in TS 38.508-1 [10] Annex A is FFS.
- Test procedure only includes the testing of smartphone and is FFS for laptop and FWA.

#### 6.5A.3.3.7.1 Test purpose

Additional spurious emission requirements are signalled by the network to indicate that the UE shall meet an additional requirement for a specific deployment scenario as part of the cell handover/broadcast message.

#### 6.5A.3.3.7.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 8UL CA.

#### 6.5A.3.3.7.3 Minimum conformance requirements

Same minimum conformance requirements as in clause 6.5A.3.3.0.

#### 6.5A.3.3.7.4 Test description

Same test description as in clause 6.5A.3.3.1.4.

#### 6.5A.3.3.7.5 Test requirement

The test requirement is the same as in clause 6.5A.3.3.1.5

## 6.5D Output RF spectrum emissions for UL MIMO

### 6.5D.1 Occupied bandwidth for UL MIMO

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- OTA test procedure for UL MIMO is still under investigation
- Measurement Uncertainty is FFS

#### 6.5D.1.1 Test purpose

To verify that the UE occupied bandwidth for all transmission bandwidth configurations supported by the UE supporting UL MIMO are less than their specific limits when UE is configured using UL MIMO transmission.

#### 6.5D.1.2 Test applicability

This test applies to all types of NR UE release 15 and forward that supporting UL MIMO.

#### 6.5D.1.3 Minimum conformance requirements

For UE configured with UL MIMO, the minimum conformance requirements are defined in clause 6.5.1.3. The requirements shall be met with the UL MIMO configurations specified in Table 6.5D.1.3-1.

**Table 6.5D.1.3-1: UL MIMO configuration**

Transmission scheme	DCI format	TPMI Index
Codebook based uplink	DCI format 0_1	0

The normative reference for this requirement is TS 38.101-2 [3] clause 6.5D.1.

#### 6.5D.1.4 Test description

##### 6.5D.1.4.1 Initial conditions

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, test channel bandwidths and sub-carrier spacing based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each combination of channel bandwidth and subcarrier spacing, are shown in Table 6.5D.1.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.5D.1.4.1-1: Test Configuration Table**

Initial Conditions	
Test Environment as specified in TS 38.508-1 [10] clause 4.1	Normal
Test Frequencies as specified in TS 38.508-1 [10] clause 4.3.1	Low range, Mid range, High range

Test Channel Bandwidths as specified in TS 38.508-1 [10] clause 4.3.1		All	
Test SCS as specified in Table 5.3.5-1		Lowest	
Test Parameters			
Test ID	Downlink Configuration	Uplink Configuration	
		Modulation	RB allocation (NOTE 1)
1	-	CP-OFDM QPSK	Outer_full
NOTE 1: The specific configuration of each RB allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.			

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and clause A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] clause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement channels are set according to Table 6.5D.1.4.1-1.
5. Propagation conditions are set according to Annex B.0
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity NR, Connected without release On, Test Mode On and Test Loop Function On according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.5D.1.4.3

#### 6.5D.1.4.2 Test procedure

1. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.5D.1.4.1-1. Since the UL has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC. The PDCCH DCI format 0\_1 is specified with condition 2TX\_UL\_MIMO in 38.508-1 [10] subclause 4.3.6.1.1.2
2. Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
3. Send continuously uplink power control "up" commands in every uplink scheduling information to the UE; allow at least 200 ms for the UE to reach maximum output power. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
4. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
5. Measure the EIRP spectrum distribution within two times or more frequency range over the requirement for Occupied Bandwidth specification centring on the current carrier frequency. The characteristics of the filter shall be approximately Gaussian (typical spectrum analyser filter). The measuring duration is one active uplink subframe. EIRP is captured from both polarizations, theta and phi.
6. Calculate the total EIRP from both polarizations, theta and phi, within the range of all frequencies measured in step 5 and save this value as "Total EIRP". EIRP measurement procedure is defined in Annex K.
7. Identify the measurement window whose centre is aligned on the centre of the channel for which the sum of the power measured in theta and phi polarization is 99% of the "Total EIRP".
8. The "Occupied Bandwidth" is the width of the measurement window obtained in step 7.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

#### 6.5D.1.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 ensuring Table 4.6.3-182 with condition 2TX\_UL\_MIMO.

## 6.5D.1.5 Test requirement

The measured Occupied Bandwidth shall not exceed values in Table 6.5D.1.5-1.

**Table 6D.5.1.5-1: Occupied channel bandwidth**

	Occupied channel bandwidth / Channel bandwidth			
	50 MHz	100 MHz	200 MHz	400 MHz
Channel bandwidth (MHz)	50	100	200	400

## 6.5D.2 Out of band emission for UL MIMO

## 6.5D.2.1 Spectrum Emission Mask for UL MIMO

Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:

- OTA test procedure for UL MIMO is still under investigation
- TRP Measurement Uncertainty is FFS.

## 6.5D.2.1.1 Test purpose

To verify that the power of any UE emission shall not exceed specified level for the specified channel bandwidth.

## 6.5D.2.1.2 Test applicability

This test case applies to all types of NR UE release 15 and forward supporting UL MIMO.

## 6.5D.2.1.3 Minimum conformance requirements

For UE(s) supporting UL MIMO, the Spectrum Emission Mask requirements in clause 6.5.2.1.3 apply. The requirements shall be met with the UL MIMO configurations specified in Table 6.2D.1.0-1.

The normative reference for this requirement is TS 38.101-2 [3] clause 6.5D.2.

## 6.5D.2.1.4 Test description

## 6.5D.2.1.4.1 Initial condition

Same initial condition in clause 6.5.2.1.4.1 with following exceptions:

- Instead of Table 6.5.2.1.4.1-1 → use Table 6.5D.2.1.4.1-1.
- Instead of Table 6.5.2.1.4.1-2 → use Table 6.5D.2.1.4.1-2

**Table 6.5D.2.1.4.1-1: Test Configuration Table**

Initial Conditions			
Test Environment as specified in TS 38.508-1 [10] subclause 4.1		Normal	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1		Mid range	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1		Lowest, Highest	
Test SCS as specified in Table 5.3.5-1		Highest	
Test Parameters			
Test ID	Downlink Configuration	Uplink Configuration	
	-	Modulation	RB allocation (NOTE 1)
1		CP-OFDM QPSK	Outer_Full



2	CP-OFDM 16 QAM	Outer_Full
3	CP-OFDM 64 QAM	Outer_Full
NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.		
NOTE 2: All test points in this table must also exist in Table 6.2D.2.4.1-1, Table 6.2D.2.4.1-2, Table 6.2D.2.4.1-3 (MPR) for PC1 or Table 6.2D.2.4.1-4, Table 6.2D.2.4.1-5, Table 6.2D.2.4.1-6 (MPR) for PC2, PC3 and PC4.		

**Table 6.5D.2.1.4.1-2: Void****6.5D.2.1.4.2 Test procedure**

Same test procedure as in clause 6.5.2.1.4.2.

**6.5D.2.1.4.3 Message contents**

Message contents are according to TS 38.508-1 [10] subclause 4.6 ensuring Table 4.6.3-182 with condition 2TX\_UL\_MIMO.

**6.5D.2.1.5 Test requirements**

The test requirement is the same as in clause 6.5.2.1.5.

**6.5D.2.2 Adjacent channel leakage ratio for UL MIMO**

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- OTA test procedure for UL MIMO is still under investigation
- TRP Measurement Uncertainty is FFS.
- Testability for PC1, 2 and 4 is FFS.

**6.5D.2.2.1 Test purpose**

To verify that the power of any UE emission shall not exceed specified level for the specified channel bandwidth.

**6.5.2.2.2 Test applicability**

This test case applies to all types of NR UE release 15 and forward supporting UL MIMO.

**6.5D.2.2.3 Minimum conformance requirements**

For UE(s) supporting UL MIMO, the Adjacent channel leakage ratio requirements in clause 6.5.2.3.3 apply. The requirements shall be met with the UL MIMO configurations specified in Table 6.2D.1.0-1.

The normative reference for this requirement is TS 38.101-2 [3] clause 6.5D.2.

**6.5D.2.2.4 Test description****6.5D.2.2.4.1 Initial condition**

Same initial condition in clause 6.5.2.3.4.1 with following exceptions:

- Instead of Table 6.5.2.3.4.1-1 → use Table 6.5D.2.2.4.1-1.
- Instead of Table 6.5.2.3.4.1-2 → use Table 6.5D.2.2.4.1-2.

**Table 6.5D.2.2.4.1-1: Test Configuration Table (Power Class 1)**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal, TL, TH		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1				Low range, Mid range, High range		
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1				Lowest, Highest		
Test SCS as specified in Table 5.3.5-1				Lowest, Highest		
Test Parameters						
Test ID	Freq	ChBw	SCS	Downlink Configuration	Uplink Configuration	
		Default	Default	-	Modulation	RB allocation (NOTE 1)
1	Low				CP-OFDM QPSK	8@0
2	High				CP-OFDM QPSK	8@N <sub>RB</sub> -8
3	Mid				CP-OFDM QPSK	Outer_Full
4	Low				CP-OFDM 16 QAM	8@0
5	High				CP-OFDM 16 QAM	8@N <sub>RB</sub> -8
6	Mid				CP-OFDM 16 QAM	Outer_Full
7	Low				CP-OFDM 64 QAM	8@0
8	High				CP-OFDM 64 QAM	8@N <sub>RB</sub> -8
9	Mid				CP-OFDM 64 QAM	Outer_Full
NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.						
NOTE 2: Applicability of test IDs for for CHBWs and frequency ranges is FFS. NOTE 3: All test points in this table must also exist in Table 6.2.2.4.1-1, Table 6.2.2.4.1-2, Table 6.2.2.4.1-3 (MPR).						

**Table 6.5D.2.2.4.1-2: Test Configuration Table (Power Class 2, 3 and 4)**

Default Conditions						
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal, TL, TH		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1				Low range, High range		
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1				Lowest, Highest		
Test SCS as specified in Table 5.3.5-1				Lowest, Highest		
Test Parameters						
Test ID	Freq	ChBw	SCS	Downlink Configuration	Uplink Configuration	
		Default	Default	-	Modulation	RB allocation (NOTE 1)
1	Low				CP-OFDM QPSK	Outer_1RB_Left
2	High				CP-OFDM QPSK	Outer_1RB_Right
3	Default				CP-OFDM QPSK	Outer Full
4	Low				CP-OFDM 16 QAM	Outer_1RB_Left
5	High				CP-OFDM 16 QAM	Outer_1RB_Right
6	Default				CP-OFDM 16 QAM	Outer Full
7	Low				CP-OFDM 64 QAM	Outer_1RB_Left
8	High				CP-OFDM 64 QAM	Outer_1RB_Right
9	Default				CP-OFDM 64 QAM	Outer Full
NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-1 for PC2, PC3 and PC4 or Table 6.1-2 for PC1.						
NOTE 2: Following Test IDs shall be skipped for FR2b - All Test IDs for 400MHz Channel Bandwidth - All Test IDs for 200MHz Channel Bandwidth - Test ID 7-9 for 100MHz Channel Bandwidth						
NOTE 3: All test points in this table must also exist in Table 6.2D.2.4.1-4, Table 6.2D.2.4.1-5, Table 6.2D.2.4.1-6 (MPR).						

6.5D.2.2.4.2 Test procedure

Same test procedure as in clause 6.5.2.3.4.2.

6.5D.2.2.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 ensuring Table 4.6.3-182 with condition 2TX\_UL\_MIMO.

6.5D.2.2.5 Test requirements

The test requirement is the same as in clause 6.5.2.3.5 with the following exceptions:

- Instead of Table 6.5.2.3.5-1b → use Table 6.5D.2.2.5-1 for Power class 1.
- Instead of Table 6.5.2.3.5-1b → use Table 6.5D.2.2.5-2 for Power class 2.
- Instead of Table 6.5.2.3.5-1b → use Table 6.5D.2.2.5-3 for Power class 3.
- Instead of Table 6.5.2.3.5-1b → use Table 6.5D.2.2.5-4 for Power class 4.

**Table 6.5D.2.2.5-1: Relaxation due to testability limit (Adjacent channel leakage ratio) for (Power Class 1)**

FFS

**Table 6.5D.2.2.5-2: Relaxation due to testability limit (Adjacent channel leakage ratio) for (Power Class 2)**

FFS

**Table 6.5D.2.2.5-3: Relaxation due to testability limit (Adjacent channel leakage ratio) for (Power Class 3)**

	Test ID	Channel bandwidth / NR <sub>ACLR</sub> / Measurement bandwidth			
		50 MHz	100 MHz	200 MHz	400 MHz
NR <sub>ACLR</sub> for band n257, n258, n261	1	0	0	0	3
	2	0	0	0	3
	3	0	0	0	3
	4	0	0	0	5.5
	5	0	0	0	5.5
	6	0	0	0	5.5
	7	0	0.5	3.5	8
	8	0	0.5	3.5	8
	9	0	0.5	3.5	8

NOTE 1: Relaxation value is derived by Table 6.5.2.3.5-1c for FR2a.

**Table 6.5D.2.2.5-4: Relaxation due to testability limit (Adjacent channel leakage ratio) for (Power Class 4)**

FFS

6.5D.3 Spurious emissions for UL MIMO

6.5D.3.1 Transmitter Spurious emissions for UL MIMO

Editor’s note: This clause is incomplete. The following aspects are either missing or not yet determined:

- OTA test procedure for UL MIMO is still under investigation

- TRP Measurement Uncertainty is FFS.
- Connection diagram between SS and UE in TS 38.508-1 [10] Annex A is FFS.
- Test procedure only includes the testing of smartphone and is FFS for laptop and FWA.

#### 6.5D.3.1.1 Test purpose

To verify that UE transmitter does not cause unacceptable interference to other channels or other systems in terms of transmitter spurious emissions.

#### 6.5D.3.1.2 Test applicability

This test case applies to all types of NR UE release 15 and forward supporting UL MIMO.

#### 6.5D.3.1.3 Minimum conformance requirements

For UE configured with UL MIMO, the minimum conformance requirements are defined in clause 6.5.3.1.3. The requirements shall be met with the UL MIMO configurations specified in Table 6.5D.3.1.3-1.

**Table 6.5D.3.1.3-1: UL MIMO configuration**

Transmission scheme	DCI format	TPMI Index
Codebook based uplink	DCI format 0_1	0

The normative reference for this requirement is TS 38.101-2 [3] clause 6.5D.3.

#### 6.5D.3.1.4 Test description

##### 6.5D.3.1.4.1 Initial condition

Same initial condition in clause 6.5.3.1.4.1 with following exceptions:

- Instead of DFT-s -OFDM → use CP-OFDM.

##### 6.5D.3.1.4.2 Test procedure

Same test procedure as in clause 6.5.3.1.4.2 with the following added to step 3 for UL MIMO configuration:

- 3.1 The PDCCH DCI format 0\_1 is specified with the condition 2TX\_UL\_MIMO in 38.508-1 [10] subclause 4.3.6.1.1.2.

##### 6.5D.3.1.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 ensuring Table 4.6.3-182 with condition 2TX\_UL\_MIMO.

##### 6.5D.3.1.5 Test requirements

The test requirement is the same as in clause 6.5.3.1.5.

### 6.5D.3.2 Spurious emission band UE co-existence for UL MIMO

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- OTA test procedure for UL MIMO is still under investigation
- TRP Measurement Uncertainty is FFS.
- Applicability of Beam peak of single UL is FFS.

- Connection diagram between SS and UE in TS 38.508-1 [10] Annex A is FFS.
- Test procedure only includes the testing of smartphone and is FFS for laptop and FWA.

#### 6.5D.3.2.1 Test purpose

To verify that UL MIMO configured UE's transmitter does not cause unacceptable interference when in co-existence with protected bands in terms of transmitter spurious emissions.

#### 6.5D.3.2.2 Test applicability

This test case applies to all types of NR UE release 15 and forward supporting UL MIMO.

#### 6.5D.3.2.3 Minimum conformance requirements

For UE configured with UL MIMO, the minimum conformance requirements are defined in clause 6.5.3.2.3. The requirements shall be met with the UL MIMO configurations specified in Table 6.5D.3.1.3-1.

The normative reference for this requirement is TS 38.101-2 [3] clause 6.5D.3.

#### 6.5D.3.2.4 Test description

##### 6.5D.3.2.4.1 Initial condition

Same initial condition in clause 6.5.3.2.4.1 with following exceptions:

- Instead of DFT-s -OFDM → use CP-OFDM.

##### 6.5D.3.2.4.2 Test procedure

Same test procedure as in clause 6.5.3.2.4.2 with the following added to step 3 for UL MIMO configuration:

- 3.1 The PDCCH DCI format 0\_1 is specified with the condition 2TX\_UL\_MIMO in 38.508-1 [10] subclause 4.3.6.1.1.2.

##### 6.5D.3.2.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 ensuring Table 4.6.3-182 with condition 2TX\_UL\_MIMO.

##### 6.5D.3.2.5 Test requirements

The test requirement is the same as in clause 6.5.3.2.5.

### 6.5D.3.3 Additional spurious emissions for UL MIMO

**Editor's note:** This clause is incomplete. The following aspects are either missing or not yet determined:

- OTA test procedure for UL MIMO is still under investigation
- TRP Measurement Uncertainty is FFS.
- Applicability of Beam peak of single UL is FFS.
- Connection diagram between SS and UE in TS 38.508-1 [10] Annex A is FFS.
- Test procedure only includes the testing of smartphone and is FFS for laptop and FWA.

#### 6.5D.3.3.1 Test purpose

Additional spurious emission requirements are signalled by the network to indicate that the UE shall meet an additional requirement for a specific deployment scenario as part of the cell handover/broadcast message.

### 6.5D.3.3.2 Test applicability

This test case applies to all types of NR UE release 15 and forward supporting UL MIMO.

### 6.5D.3.3.3 Minimum conformance requirements

For UE configured with UL MIMO, the minimum conformance requirements are defined in clause 6.5.3.3.3. The requirements shall be met with the UL MIMO configurations specified in Table 6.5D.3.1.3-1.

The normative reference for this requirement is TS 38.101-2 [3] clause 6.5D.3.

### 6.5D.3.3.4 Test description

#### 6.5D.3.3.4.1 Initial condition

Same initial condition in clause 6.5.3.3.4.1 with following exceptions:

- Instead of DFT-s -OFDM → use CP-OFDM.

#### 6.5D.3.3.4.2 Test procedure

Same test procedure as in clause 6.5.3.3.4.2 with the following added to step 3 for UL MIMO configuration:

- 3.1 The PDCCH DCI format 0\_1 is specified with the condition 2TX\_UL\_MIMO in 38.508-1 [10] subclause 4.3.6.1.1.2.

#### 6.5D.3.3.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 ensuring Table 4.6.3-182 with condition 2TX\_UL\_MIMO.

#### 6.5D.3.3.5 Test requirements

The test requirement is the same as in clause 6.5.3.3.5.

## 6.6 Beam correspondence

### 6.6.0 General

Beam correspondence is the ability of the UE to select a suitable beam for UL transmission based on DL measurements with or without relying on UL beam sweeping. The beam correspondence requirement is satisfied assuming the presence of both SSB and CSI-RS signal and Type D QCL is maintained between SSB and CSI-RS.

Enhanced Beam correspondence is the ability of the UE to select a suitable beam for UL transmission based on DL measurements with or without relying on UL beam sweeping. The beam correspondence requirement is satisfied assuming the presence of either SSB and CSI-RS signal.

### 6.6.1 Beam correspondence - EIRP

**Editor's note: The following aspects are either missing or not yet determined:**

- Measurement Uncertainties and Test Tolerances are FFS for power class1, 2 and 4.
- The test case is incomplete for band n259.

#### 6.6.1.1 Test purpose

To verify the UE's ability to select a suitable beam for UL transmission based on DL measurements with or without relying on UL beam sweeping within the range prescribed by the specified nominal maximum output power and beam correspondence tolerance.

### 6.6.1.2 Test applicability

This test case applies to all types of NR UE release 15 that do not support beam correspondence without UL beam sweeping.

This test case applies to all types of NR UE release 16 and forward that do not support SSB-based or CSI-RS based enhanced beam correspondence and do not support enhanced beam correspondence without UL beam sweeping.

### 6.6.1.3 Minimum conformance requirements

6.6.1.3.1 (Void)

6.6.1.3.2 (Void)

### 6.6.1.3.3 Beam correspondence for PC3

#### 6.6.1.3.3.1 General

The beam correspondence requirement for PC3 UEs consists of three components: UE minimum peak EIRP (as defined in clause 6.2.1.1.3.3), UE spherical coverage (as defined in clause 6.2.1.1.3.3), and beam correspondence tolerance (as defined in clause 6.6.1.3.3.2). The beam correspondence requirement is fulfilled if the UE satisfies one of the following conditions, depending on the UE's beam correspondence capability IE *beamCorrespondenceWithoutUL-BeamSweeping*, as defined in TS 38.306 [26]:

- If *beamCorrespondenceWithoutUL-BeamSweeping* is supported, the UE shall meet the minimum peak EIRP requirement according to Table 6.2.1.1.3.3-1 and spherical coverage requirement according to Table 6.2.1.1.3.3-3 with its autonomously chosen UL beams and without uplink beam sweeping. Such a UE is considered to have met the beam correspondence tolerance requirement.
- If *beamCorrespondenceWithoutUL-BeamSweeping* is not present, the UE shall meet the minimum peak EIRP requirement according to Table 6.2.1.1.3.3-1 and spherical coverage requirement according to Table 6.2.1.1.3.3-3 with uplink beam sweeping. Such a UE shall meet the beam correspondence tolerance requirement defined in Clause 6.6.1.3.3.2 and shall support uplink beam management, as defined in TS 38.306 [26].

#### 6.6.1.3.3.1.1 Side condition for SSB and CSI-RS

The beam correspondence requirements are only applied under the following conditions:

- The downlink reference signals including both SSB and CSI-RS are provided and Type D QCL shall be maintained between SSB and CSI-RS.
- The reference measurement channel for beam correspondence are fulfilled according to the CSI-RS configuration in Annex A.3.
- The beam correspondence conditions for L1-RSRP measurements are fulfilled according to Table 6.6.1.3.3.1.1-1 and Table 6.6.1.3.3.1.1-2.

**Table 6.6.1.3.3.1.1-1: Conditions for SSB based L1-RSRP measurements for beam correspondence**

Angle of arrival	NR operating bands	Minimum SSB_RP <sup>Note 2</sup>		SSB $\hat{E}_s/\text{lot}$ dB
		dBm / SCS <sub>SSB</sub>		
		SCS <sub>SSB</sub> = 120 kHz		
All angles <sup>Note 1</sup>	n257	-92.2		≥6
	n258	-96.2		
	n259	-90.7		
	n260	-91.9		
	n261	-96.2		
NOTE 1: For UEs that support multiple FR2 bands, the Minimum SSB_RP values for all angles are increased by $\Delta\text{MB}_{s,n}$ , the UE multi-band relaxation factor in dB specified in clause 6.2.1.				

NOTE 2: Values specified at the radiated requirements reference point to give minimum SSB  $\bar{E}_s/\text{lot}$ , with no applied noise.

**Table 6.6.1.3.3.1.1-2: Conditions for CSI-RS based L1-RSRP measurements for beam correspondence**

Angle of arrival	NR operating bands	Minimum CSI-RS_RP <sup>Note 2</sup>	
		dBm / $SCS_{\text{CSI-RS}}$	
		$SCS_{\text{CSI-RS}} = 120 \text{ kHz}$	
			CSI-RS $\bar{E}_s/\text{lot}$ dB
All angles <sup>Note 1</sup>	n257	-96.2	$\geq 6$
	n258	-96.2	
	n259	-90.7	
	n260	-91.9	
	n261	-96.2	
NOTE 1: For UEs that support multiple FR2 bands, the Minimum CSI-RS_RP values are increased by $\Delta MB_{S,n}$ , the UE multi-band relaxation factor in dB specified in clause 6.2.1.			
NOTE 2: Values specified at the radiated requirements reference point to give minimum CSI-RS $\bar{E}_s/\text{lot}$ , with no applied noise.			

6.6.1.3.3.2 Beam correspondence tolerance for PC3

The beam correspondence tolerance requirement  $\Delta EIRP_{BC}$  for power class 3 UEs is defined based on a percentile of the distribution of  $\Delta EIRP_{BC}$ , defined as  $\Delta EIRP_{BC} = EIRP_2 - EIRP_1$  over the link angles spanning a subset of the spherical coverage grid points, such that

- $EIRP_1$  is the total EIRP in dBm calculated based on the beam the UE chooses autonomously (corresponding beam) to transmit in the direction of the incoming DL signal, which is based on beam correspondence without relying on UL beam sweeping.
- $EIRP_2$  is the best total EIRP (beam yielding highest EIRP in a given direction) in dBm which is based on beam correspondence with relying on UL beam sweeping.
- The link angles are the ones corresponding to the top  $N^{\text{th}}$  percentile of the  $EIRP_2$  measurement over the whole sphere, where the value of N is according to the test point of EIRP spherical coverage requirement for power class 3, i.e.  $N = 50$ .

For power class 3 UEs, the requirement is fulfilled if the UE’s corresponding UL beams satisfy the maximum limit in Table 6.6.1.3.3.2-1.

**Table 6.6.1.3.3.2-1: UE beam correspondence tolerance for power class 3**

Operating band	Max $\Delta EIRP_{BC}$ at 85 %-tile $\Delta EIRP_{BC}$ CDF (dB)
n257	3.0
n258	3.0
n260	3.2
n261	3.0
NOTE: The requirements in this table are verified only under normal temperature conditions as defined in TS 38.508-1 [10] subclause 4.1.1	

6.6.1.3.4 Normative reference

The normative reference for this requirement is TS 38.101-2 [3] clause 6.6.4.



## 6.6.1.4 Test description

## 6.6.1.4.1 Initial conditions

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, and channel bandwidths based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each channel bandwidth and subcarrier spacing, are shown in Table 6.6.1.4.1-1. The details of the uplink reference measurement channels (RMCs) are specified in Annexes A.2. The downlink reference measurement channels (RMCs) are specified in Annex A.3. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 6.6.1.4.1-1: Test Configuration Table for PC3**

Default Conditions					
Test Environment as specified in TS 38.508-1 [10] subclause 4.1				Normal	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1				Low range, High range	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1				Lowest, Highest	
Test SCS as specified in Table 5.3.5-1				120 kHz	
Test Parameters					
Test ID	ChBw	SCS	Downlink Configuration	Uplink Configuration	
		Default	-	Modulation	RB allocation (NOTE 1)
1	50			DFT-s-OFDM QPSK	Inner_Full
2	100				
3	200				
4	400				
NOTE 1: The specific configuration of each RF allocation is defined in Table 6.1-1.					

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement channels are set according to Table 6.6.1.4.1-1.
5. Propagation conditions are set according to Annex B.0
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 6.6.1.4.3.

## 6.6.1.4.2 Test procedure

Test procedure without uplink beam sweeping:

- 1.1 SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.6.1.4.1-1. Since the UL has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC. Messages to configure the appropriate uplink modulation in section 6.6.1.4.3.
- 1.2. Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1 without uplink beam sweeping (i.e., not executing steps 5.1) to step 5.5) in Annex K.1.1). Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.

- 1.3. Send continuously uplink power control "up" commands in every uplink scheduling information to the UE; allow at least 200 msec to ensure that the UE transmits at its maximum output power. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
- 1.4. Measure UE EIRP<sub>1</sub> in the Tx beam peak direction in the channel bandwidth of the radio access mode according to the test configuration. Repeat EIRP<sub>1</sub> measurement for all directions in the sphere according to EIRP measurement procedure defined in Annex K.1.9 without beam sweeping for all the points in the grid. After a rotation, allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for UE to find the best beam to use. The measuring duration is one active uplink subframe. EIRP<sub>1</sub> is calculated considering both polarizations, theta and phi.
- 1.5. Record all the measured EIRP<sub>1</sub> values.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

Test procedure with uplink beam sweeping:

- 2.1. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 6.6.1.4.1-1. Since the UL has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC. Messages to configure the appropriate uplink modulation in section 6.6.1.4.3.
- 2.3. Set the UE in the Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
- 2.2. Send continuously uplink power control "up" commands in every uplink scheduling information to the UE; allow at least 200 msec to ensure that the UE transmits at its maximum output power. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Tx beam selection to complete.
- 2.4. Measure UE EIRP in the Tx beam peak direction in the channel bandwidth of the radio access mode according to the test configuration. Repeat EIRP measurements for all directions in the sphere according to EIRP measurement procedure defined in Annex K.1.9 with beam sweeping. After a rotation, allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for UE to find the best beam to use. The measuring duration is one active uplink subframe. EIRP is calculated considering both polarizations, theta and phi.
- 2.5. Record all the measured EIRP<sub>2</sub> values.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

- 2.6. Calculate the  $\Delta\text{EIRP}_{\text{BC}} = \text{EIRP}_2 - \text{EIRP}_1$ .
- 2.7. Calculate a cumulative distribution function for the  $\Delta\text{EIRP}_{\text{BC}}$  values.

NOTE 2: The  $\Delta\text{EIRP}_{\text{target-CDF}}$  is then obtained from the Cumulative Distribution Function (CDF) computed using  $\Delta\text{EIRP}_{\text{BC}}$  for each of all top N<sup>th</sup> percentile of the EIRP<sub>2</sub> measurement points in the grid. When using constant step size measurement grids, a theta-dependent correction shall be applied, i.e., the PDF probability contribution for each measurement point is scaled by  $\sin(\theta)$  or the normalized Clenshaw-Curtis weights  $W(\theta)/W(90^\circ)$ , introduced in Section M.4.2.1.

#### 6.6.1.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with TRANSFORM\_PRECODER\_ENABLED condition in Table 4.6.3-118 PUSCH-Config and with following exceptions:

**Table 6.6.1.4.3-1: SRS-Config: SpatialRelationInfo test requirement for with beam sweeping**

Derivation Path: TS 38.508-1 [10], clause 4.6.3, Table 4.6.3-182			
Information Element	Value/remark	Comment	Condition
spatialRelationInfo	Not present	The UE can consider the UL beam sweeping.	

**Table 6.6.1.4.3-2: SRS-Config: SpatialRelationInfo test requirement for without beam sweeping**

Derivation Path: TS 38.508-1 [10], clause 4.6.3, Table 4.6.3-182			
Information Element	Value/remark	Comment	Condition
spatialRelationInfo	SRS-SpatialRelationInfo	The UE consider autonomous beam selection	

**Table 6.6.1.4.3-3: SRS-Config: ssb-Index test requirement for without beam sweeping**

Derivation Path: TS 38.508-1 [10], clause 4.6.3, Table 4.6.3-182			
Information Element	Value/remark	Comment	Condition
ssb-Index	SSB-Index		

**Table 6.6.1.4.3-4: SRS-Config: SRS resources test requirement for with beam sweeping**

Derivation Path: TS 38.508-1 [10], clause 4.6.3, Table 4.6.3-182			
Information Element	Value/remark	Comment	Condition
srs-ResourceSetToReleaseList	Not present		
srs-ResourceSetToAddModList SEQUENCE (SIZE(1..maxNrofSRS-ResourceSets)) OF SEQUENCE {	2 entries	1 set with 8 SRS resources using 'beamManagement' plus 1 set with 1 semi-persistent SRS resource using 'codebook'	
SRS-ResourceSet[1] SEQUENCE{		For the 'beamManagement' resource set	
usage	beamManagement		
resourceType CHOICE {	aperiodic		
}			
SRS-ResourceSet[2] SEQUENCE{		For the semi-persistent SRS resource set	
usage	codebook		
resourceType CHOICE {	semi-persistent		
}			
srs-ResourceToReleaseList	Not present		
srs_ResourceToAddModList	9	The default beam correspondence SRS resource upper limit (M) = 8 in Rel-15 for the 'beamManagement' SRS Resource set plus 1 resource for the semi-persistent SRS 'codebook' resource set.	

**Table 6.6.1.4.3-5: CSI-RS-ResourceMapping: CSI-RS test requirements**

Derivation Path: TS 38.508-1 [10], clause 4.6.3, Table 4.6.3-45			
Information Element	Value/remark	Comment	Condition
CSI-RS-ResourceMapping ::= SEQUENCE {			
frequencyDomainAllocation CHOICE {			
row1	0001	k0 = 0, row1, 1Tx test cases	
}			

nrofPorts	p1	1Tx test cases	
firstOFDMSymbolInTimeDomain	6 for resource #0		
	7 for resource #1		
	8 for resource #2		
	9 for resource #3		
	10 for resource #4		
	11 for resource #5		
	12 for resource #6		
13 for resource #7			
cdm-Type	noCDM		
density CHOICE {			
three	NULL		
}			
freqBand	CSI-FrequencyOccupation		
}			

**Table 6.6.1.4.3-6: NZP-CSI-RS-Resource: CSI-RS test requirements**

Derivation Path: TS 38.508-1 [10], clause 4.6.3, Table 4.6.3-85			
Information Element	Value/remark	Comment	Condition
NZP-CSI-RS-Resource ::= SEQUENCE {			
nzp-CSI-RS-ResourceId	NZP-CSI-RS-ResourceId		
resourceMapping	CSI-RS-ResourceMapping		
powerControlOffset	0		
powerControlOffsetSS	db0		
scramblingID	ScramblingId		
periodicityAndOffset	CSI-ResourcePeriodicityAndOffset		
qcl-InfoPeriodicCSI-RS	TCI-StateId		
}			

**Table 6.6.1.4.3-7: NZP-CSI-RS-ResourceSet: CSI-RS test requirements**

Derivation Path: TS 38.508-1 [10], clause 4.6.3, Table 4.6.3-87			
Information Element	Value/remark	Comment	Condition
NZP-CSI-RS-ResourceSet ::= SEQUENCE {			
nzp-CSI-ResourceSetId	NZP-CSI-RS-ResourceSetId		
nzp-CSI-RS-Resources SEQUENCE (SIZE (1..maxNrofNZP-CSI-RS-ResourcesPerSet)) OF {	[1 entry]		
NZP-CSI-RS-ResourceId[1]	NZP-CSI-RS-ResourceId		
}			
repetition	on		
aperiodicTriggeringOffset	0	Depending on UE capability	
trs-Info	Not present		
}			

**Table 6.6.1.4.3-8: NZP-CSI-RS-ResourceId: CSI-RS test requirements**

Derivation Path: TS 38.508-1 [10], clause 4.6.3, Table 4.6.3-86			
Information Element	Value/remark	Comment	Condition
NZP-CSI-RS-ResourceId	30 for resource #0		
	31 for resource #1		
	32 for resource #2		
	33 for resource #3		
	34 for resource #4		
	35 for resource #5		

	36 for resource #6		
	37 for resource #7		

**Table 6.6.1.4.3-9: CSI-ResourceConfig: CSI-RS test requirements**

Derivation Path: TS 38.508-1 [10], clause 4.6.3, Table 4.6.3-39			
Information Element	Value/remark	Comment	Condition
CSI-ResourceConfig ::= SEQUENCE {			
csi-ResourceConfigId	CSI-ResourceConfigId		
csi-RS-ResourceSetList CHOICE {			
nzp-CSI-RS-SSB SEQUENCE {			
nzp-CSI-RS-ResourceSetList SEQUENCE (SIZE (1..maxNrofNzp-CSI-RS-ResourceSetsPerConfig))	2 entries		
OF {			
Nzp-CSI-RS-ResourceSetId[0]	0		
Nzp-CSI-RS-ResourceSetId[1]	1		
}			
csi-SSB-ResourceSetList	Not present		
}			
bwp-Id	BWP-Id		
resourceType	aperiodic		
}			

**Table 6.6.1.4.3-10: CSI-FrequencyOccupation: CSI-RS test requirements**

Derivation Path: TS 38.508-1 [10], clause 4.6.3, Table 4.6.3-33			
Information Element	Value/remark	Comment	Condition
CSI-FrequencyOccupation ::= SEQUENCE {			
startingRB	0		
nrofRBs	48		FR2_≥100MHz
	32		FR2_50MHz
}			

### 6.6.1.5 Test requirements

The defined %-tile EIRP in measurement distribution derived in step 2.6 shall exceed the values specified in Table 6.2.1.2.5-3 in clause 6.2.1.2.5. The defined %-tile  $\Delta\text{EIRP}_{\text{BC}}$  in measurement distribution derived in step 2.7 shall not exceed the values specified in Table 6.6.1.5-1 and Table 6.6.1.5-2.

**Table 6.6.1.5-1: UE beam correspondence tolerance for power class 3**

Operating band	Max $\Delta\text{EIRP}_{\text{BC}}$ at 85 <sup>th</sup> %-tile $\Delta\text{EIRP}_{\text{BC}}$ CDF (dB)
n257	3.0 +TT
n258	3.0 +TT
n260	3.2 +TT
n261	3.0 +TT
NOTE: The requirements in this table are verified only under normal temperature conditions as defined in TS 38.508-1 [10] subclause 4.1.1	

**Table 6.6.1.5-2: Test Tolerance (TT) for UE beam correspondence tolerance for power class 3**

Operating band	Test Tolerance (dB)
n257, n258, n260, n261	1.26
n259	FFS

## 6.6.2 Enhanced Beam correspondence – EIRP

### 6.6.2.1 Test purpose

To verify the UE's ability to select a suitable beam for UL transmission based on DL measurements with or without relying on UL beam sweeping within the range prescribed by the specified nominal maximum output power and beam correspondence tolerance.

### 6.6.2.2 Test applicability

This test case applies to all types of NR UE release 16 and forward that support either CSI-RS or SSB based beam correspondence and do not support beam correspondence without UL beam sweeping.

### 6.6.2.3 Minimum conformance requirements

#### 6.6.2.3.1 Enhanced Beam correspondence for PC3

##### 6.6.2.3.1.1 General Test Coverage Rules

The beam correspondence requirement for PC3 UEs consists of three components: UE minimum peak EIRP (as defined in clause 6.2.1.1.3.3), UE spherical coverage (as defined in clause 6.2.1.1.3.3), and beam correspondence tolerance (as defined in clause 6.6.1.3.3.2). The beam correspondence requirement is fulfilled if the UE satisfies one of the following conditions, depending on the UE's beam correspondence capability IE *beamCorrespondenceWithoutUL-BeamSweeping*, as defined in TS 38.306 [26]:

- If *beamCorrespondenceWithoutUL-BeamSweeping* and *beamCorrespondenceSSB-based-r16* are supported, the UE shall meet the minimum peak EIRP requirement according to Table 6.2.1.1.3.3-1 and spherical coverage requirement according to Table 6.2.1.1.3.3-3 using the side conditions for SSB based enhanced beam correspondence requirements as defined in Clause 6.6.2.3.2.
- If *beamCorrespondenceWithoutUL-BeamSweeping* and *beamCorrespondenceCSI-RS-based-r16* are supported, the UE shall meet the minimum peak EIRP requirement according to Table 6.2.1.1.3.3-1 and spherical coverage requirement according to Table 6.2.1.1.3.3-3 using the side conditions for CSI-RS based enhanced beam correspondence requirements as defined in Clause 6.6.2.3.3.
- If *beamCorrespondenceWithoutUL-BeamSweeping* is not present and *beamCorrespondenceSSB-based-r16* is supported, the UE shall meet the minimum peak EIRP requirement according to Table 6.2.1.1.3.3-1 and spherical coverage requirement according to Table 6.2.1.1.3.3-3 with uplink beam sweeping using the side conditions for SSB based enhanced beam correspondence requirements as defined in Clause 6.6.2.3.2. Such a UE shall meet the beam correspondence tolerance requirement defined in Clause 6.6.1.3.3.2 and shall support uplink beam management, as defined in TS 38.306 [14].
- If *beamCorrespondenceWithoutUL-BeamSweeping* is not present and *beamCorrespondenceCSI-RS-based-r16* is supported, the UE shall meet the minimum peak EIRP requirement according to Table 6.2.1.1.3.3-1 and spherical coverage requirement according to Table 6.2.1.1.3.3-3 with uplink beam sweeping using the side conditions for CSI-RS based enhanced beam correspondence requirements as defined in Clause 6.6.2.3.3. Such a UE shall meet the beam correspondence tolerance requirement defined in Clause 6.6.1.3.3.2 and shall support uplink beam management, as defined in TS 38.306 [14].

##### 6.6.2.3.1.2 Applicability rules based on support for type of enhanced beam correspondence

For UEs supporting more than one type of beam correspondence, the following applicability rules apply:

- If a UE meets enhanced beam correspondence requirements either based on SSB or based on CSI-RS, it is considered to have met the beam correspondence requirements based on SSB and CSI-RS.
- For a UE supporting either SSB based or CSI-RS based enhanced beam correspondence, UE shall meet the supported enhanced beam correspondence requirements.
- For a UE supporting both SSB based and CSI-RS based enhanced beam correspondence, the UE shall meet both SSB based and CSI-RS based enhanced beam correspondence requirements and the following applicability rules for verifying the requirements apply:

- The enhanced beam correspondence requirements shall be verified with the SSB based enhanced beam correspondence side conditions in clause 6.6.2.3.2
- If the UE meets the SSB based enhanced beam correspondence requirements using the side conditions in clause 6.6.2.3.2 and meets the minimum peak EIRP requirement as defined in clause 6.2.1.1 using the CSI-RS based side conditions in clause 6.6.2.3.3, where the link direction is determined in the SSB based enhanced beam correspondence test, the UE is considered to have met both the SSB based and CSI-RS based enhanced beam correspondence requirements.
- Otherwise, if UE does not meet the minimum peak EIRP requirement as defined in clause 6.2.1.3 using the CSI-RS based side conditions in clause 6.6.4.3.3, the enhanced beam correspondence requirements shall be further verified for the UE with the CSI-RS based enhanced beam correspondence side conditions in clause 6.6.2.3.3.

#### 6.6.2.3.2 Side Condition for SSB based enhanced Beam Correspondence requirements

The beam correspondence requirements for beam correspondence based on SSB are only applied under the following side conditions:

- The downlink reference signal SSB is provided and CSI-RS is not provided.
- For beam correspondence, conditions for L1-RSRP measurements are fulfilled according to Table 6.6.1.3.3.1.1-1.

#### 6.6.2.3.3 Side Condition for CSI-RS based enhanced Beam Correspondence requirements

The beam correspondence requirements for beam correspondence based on CSI-RS are only applied under the following side conditions:

- The downlink reference signals including both SSB and CSI-RS are provided.
- The reference measurement channel for beam correspondence are fulfilled according to the CSI-RS configuration in Annex A.3.
- For beam correspondence, conditions for L1-RSRP measurements are fulfilled according to Table 6.6.1.3.3.1.1-2 and SSB signal is provided according to Table 6.6.2.3.3-1.

**Table 6.6.2.3.3-1: SSB signal conditions for CSI-RS based beam correspondence requirements**

Angle of arrival	NR operating bands	Minimum SSB_RP <sup>Note 2</sup>	
		dBm / SCS <sub>SSB</sub>	
		SCS <sub>SSB</sub> = 120 kHz	
			SSB $\hat{E}_s/\text{lot}$ dB
All angles <sup>Note 1</sup>	n257	-101,4	$\geq 1$
	n258	-101,4	
	n259	-97,1	
	n260	-97,1	
	n261	-101,4	
NOTE 1: For UEs that support multiple FR2 bands, the Minimum SSB_RP values for all angles are increased by $\Sigma\text{MBs}$ , the UE multi-band relaxation factor in dB specified in clause 6.2.1.			
NOTE 2: Values specified at the radiated requirements reference point to give minimum SSB $\hat{E}_s/\text{lot}$ , with no applied noise.			

#### 6.6.2.3.4 Normative reference

The normative reference for this requirement is TS 38.101-2 [3] clause 6.6.4

#### 6.6.2.4 Test description

##### 6.6.2.4.1 Initial conditions

Same as 6.6.1.4.1.

#### 6.6.2.4.2 Test procedure

The following cases are tested depending on UE capability:

1. Test procedure if *beamCorrespondenceWithoutUL-BeamSweeping* is NOT supported, uplink beam management and *beamCorrespondenceSSB-based-r16* are supported:
  - 1.1 Same as 6.6.1.4.2 with the exception that measurements shall be carried out using only side conditions defined in Table 6.6.1.3.3.1.1-1.
  - 1.2 End test procedure.
2. Test procedure if *beamCorrespondenceWithoutUL-BeamSweeping* is NOT supported, uplink beam management and *beamCorrespondenceCSI-RS-based-r16* is supported
  - 2.1 Same as 6.6.1.4.2 with the exception that measurements shall be carried out using only side conditions defined in Table 6.6.2.3.3-1.
  - 2.2 End test procedure.
3. Test procedure if *beamCorrespondenceWithoutUL-BeamSweeping* is NOT supported, uplink beam management, *beamCorrespondenceCSI-RS-based-r16* and *beamCorrespondenceSSB-based-r16* are supported
  - 3.1 Same as 6.6.1.4.2 with the exception that measurements shall be carried out using only side conditions defined in Table 6.6.1.3.3.1.1-1.
  - 3.2 If measurement performed in 6.2.1.1\_1.4.2 Step 3.2 was fail, repeat test same as 6.6.1.4.2 with the exception that measurements shall be carried out using only side conditions defined in Table 6.6.2.3.3-1.
  - 3.3 End test procedure.

#### 6.6.2.4.3 Message contents

Same as the message contents in 6.6.1.4.3

#### 6.6.2.5 Test requirements

The defined %-tile EIRP in measurement distribution derived within 6.6.2.4.2 (as per step 2.6 of clause 6.6.1.4.2) shall exceed the values specified in Table 6.2.1.2.5-3 in clause 6.2.1.2.5. The defined %-tile  $\Delta\text{EIRP}_{\text{BC}}$  in measurement distribution derived in step 2.7 shall not exceed the values specified in Table 6.6.1.5-1.

**Table 6.6.1.5-1: UE beam correspondence tolerance for power class 3**

Operating band	Max $\Delta\text{EIRP}_{\text{BC}}$ at 85 <sup>th</sup> %-tile $\Delta\text{EIRP}_{\text{BC}}$ CDF (dB)
n257	3.0 +TT
n258	3.0 +TT
n260	3.2 +TT
n261	3.0 +TT
NOTE: The requirements in this table are verified only under normal temperature conditions as defined in TS 38.508-1 [10] subclause 4.1.1.	

## 6.6A Beam correspondence for CA

### 6.6A.1 Test purpose

Same test purpose as in clause 6.6



## 6.6A.2 Test applicability

The requirements in this test covered by section 6.6 dealing with non-CA Beam Correspondence.

No test case details are specified.

## 6.6A.3 Minimum Conformance Requirements

For intra-band CA in FR2, the same beam correspondence relationship for beam management is supported across CCs in Rel-15 and no requirement is specified. Beam correspondence performance for intra-band CA is fulfilled if the beam correspondence requirements defined in section 6.6 is met for non-CA case.

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# 7 Receiver characteristics

## 7.1 General

**Editor's Note: Test configurations/environments that require new spherical scan shall be included in test procedure section and identifying such scenarios is currently FFS and owned by RAN5.**

Unless otherwise stated, the receiver characteristics are specified over the air (OTA). The reference receive sensitivity (REFSENS) is defined assuming a 0 dBi reference antenna located at the centre of the quiet zone.

For Rx test cases the identified beam peak direction can be stored and reused for a device under test in various configurations/environments for the full duration of device testing as long as beam peak direction is the same.

Unless otherwise stated, Channel Bandwidth shall be prioritized in the selecting of test points. Subcarrier spacing shall be selected after Test Channel Bandwidth is selected.

The UE under test shall be pre-configured with UL Tx diversity schemes disabled to account for single polarization System Simulator (SS) in the test environment. The UE under test may transmit with dual polarization.

## 7.2 Diversity characteristics

FFS

## 7.3 Reference sensitivity

### 7.3.1 General

The reference sensitivity power level REFSENS is the EIS level (total component) at the centre of the quiet zone in the RX beam peak direction, at which the throughput shall meet or exceed the requirements for the specified reference measurement channel.

### 7.3.2 Reference sensitivity power level

**Editor's note: The following aspects of the clause are for future consideration:**

- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.
- The test case is incomplete for band n259.

**The following aspects of the clause are for future consideration:**

- The 3D EIS scan test time optimization in RAN 4/ RAN 5 is FFS (existing EIS based test time needs to be re-evaluated for 200/266 grid points).
- Statistical model in Annex H.2 (currently based on LTE model) needs to be validated to confirm that it is also applicable for FR2

### 7.3.2.1 Test purpose

To verify the UE's ability to receive data with a given average throughput for a specified reference measurement channel, under conditions of low signal level, ideal propagation and no added noise.

A UE unable to meet the throughput requirement under these conditions will decrease the effective coverage area of an g-NodeB.

### 7.3.2.2 Test applicability

This test case applies to all types of NR UE release 15 and forward.

### 7.3.2.3 Minimum conformance requirements

The reference sensitivity power level REFSENS is defined as the EIS level at the centre of the quiet zone in the RX beam peak direction, at which the throughput shall meet or exceed the requirements for the specified reference measurement channel.

#### 7.3.2.3.1 Reference sensitivity power level for power class 1

The throughput shall be  $\geq 95$  % of the maximum throughput of the reference measurement channels as specified in Annex A.2.3.2 and A.3.3.2 (with one sided dynamic OCN Pattern OP.1 TDD for the DL-signal as described in Annex A.5.2.1) with peak reference sensitivity specified in Table 7.3.2.3.1-1. The requirement is verified with the test metric of EIS (Link=RX beam peak direction, Meas=Link Angle).

**Table 7.3.2.3.1-1: Reference sensitivity for power class 1**

Operating band	REFSENS (dBm) / Channel bandwidth			
	50 MHz	100 MHz	200 MHz	400 MHz
n257	-97.5	-94.5	-91.5	-88.5
n258	-97.5	-94.5	-91.5	-88.5
n260	-94.5	-91.5	-88.5	-85.5
n261	-97.5	-94.5	-91.5	-88.5

NOTE 1: The transmitter shall be set to  $P_{UMAX}$  as defined in subclause 6.2.4

The REFSENS requirement shall be met for an uplink transmission using QPSK DFT-s-OFDM waveforms and for uplink transmission bandwidth less than or equal to that specified in Table 7.3.2.3.1-2.

**Table 7.3.2.3.1-2: Uplink configuration for reference sensitivity**

Operating band	NR Band / Channel bandwidth / NRB / SCS / Duplex mode					
	50 MHz	100 MHz	200 MHz	400 MHz	SCS	Duplex Mode
n257	32	64	128	256	120 kHz	TDD
n258	32	64	128	256	120 kHz	TDD
n260	32	64	128	256	120 kHz	TDD
n261	32	64	128	256	120 kHz	TDD

Unless given by Table 7.3.2.3.1-3, the minimum requirements for reference sensitivity shall be verified with the network signalling value NS\_200 (Table 6.2.3.3.1-1) configured.

**Table 7.3.2.3.1-3: Reserved**

Operating band	Network Signalling value

### 7.3.2.3.2 Reference sensitivity power level for power class 2

The throughput shall be  $\geq 95\%$  of the maximum throughput of the reference measurement channels as specified in Annex A.2.3.2 and A.3.3.2 (with one sided dynamic OCNB Pattern OP.1 TDD for the DL-signal as described in Annex A.5.2.1) with peak reference sensitivity specified in Table 7.3.2.3.2-1. The requirement is verified with the test metric of EIS (Link=RX beam peak direction, Meas=Link Angle).

**Table 7.3.2.3.2-1: Reference sensitivity for power class 2**

Operating band	REFSENS (dBm) / Channel bandwidth			
	50 MHz	100 MHz	200 MHz	400 MHz
n257	-92	-89	-86	-83
n258	-92	-89	-86	-83
n261	-92	-89	-86	-83

NOTE 1: The transmitter shall be set to  $P_{UMAX}$  as defined in subclause 6.2.4

The REFSENS requirement shall be met for an uplink transmission using QPSK DFT-s-OFDM waveforms and for uplink transmission bandwidth less than or equal to that specified in Table 7.3.2.3.1-2.

Unless given by Table 7.3.2.3.1-3, the minimum requirements for reference sensitivity shall be verified with the network signalling value NS\_200 (Table 6.2.3.3.1-1) configured.

### 7.3.2.3.3 Reference sensitivity power level for power class 3

The throughput shall be  $\geq 95\%$  of the maximum throughput of the reference measurement channels as specified in Annex A.2.3.2 and A.3.3.2 (with one sided dynamic OCNB Pattern OP.1 TDD for the DL-signal as described in Annex A.5.2.1) with peak reference sensitivity specified in Table 7.3.2.3.3-1. The requirement is verified with the test metric of EIS (Link=RX beam peak direction, Meas=Link Angle).

For the power class 3 UEs that support multiple FR2 bands, the minimum requirement for Reference sensitivity in Table 7.3.2.3.3-1 shall be increased per band, respectively, by the reference sensitivity relaxation parameter  $\sum MB_P$  and  $\Delta MB_{P,n}$  as specified in Table 7.3.2.3.3-1a and 7.3.2.3.3-1b.

**Table 7.3.2.3.3-1: Reference sensitivity for power class 3**

Operating band	REFSENS (dBm) / Channel bandwidth			
	50 MHz	100 MHz	200 MHz	400 MHz
n257	-88.3	-85.3	-82.3	-79.3
n258	-88.3	-85.3	-82.3	-79.3
n259	-84.7	-81.7	-78.7	-75.7
n260	-85.7	-82.7	-79.7	-76.7
n261	-88.3	-85.3	-82.3	-79.3

NOTE 1: The transmitter shall be set to  $P_{UMAX}$  as defined in subclause 6.2.4

**Table 7.3.2.3.3-1a: UE multi-band relaxation factors for power class 3 (Rel-15)**

Supported bands	$\sum MB_P$ (dB)	$\sum MB_S$ (dB)
n257, n258	$\leq 1.3$	$\leq 1.25$
n257, n260	$\leq 1.0$	$\leq 0.75^3$
n258, n260	$\leq 1.0$	$\leq 0.75^3$
n258, n261	$\leq 1.0$	$\leq 1.25$
n260, n261	0.0	$\leq 0.75^2$
n257, n258, n260	$\leq 1.7$	$\leq 1.75^3$
n257, n258, n261	$\leq 1.7$	$\leq 1.75$
n257, n260, n261	$\leq 0.5$	$\leq 1.25^3$
n258, n260, n261	$\leq 1.5$	$\leq 1.25^3$
n257, n258, n260, n261	$\leq 1.7$	$\leq 1.75^3$

NOTE 1: The requirements in this table are applicable to UEs which support only the indicated bands  
NOTE 2: For supported bands n260 + n261,  $\Delta MB_{S,n}$  is not applied for band n260  
NOTE 3: For n260, maximum applicable  $\Delta MB_{S,n}$  is 0.4 dB and  $\Delta MB_{P,n}$  is 0.75 dB  
NOTE 4: For all bands except n260, the maximum applicable  $\Delta MB_{P,n}$  and  $\Delta MB_{S,n}$  is 0.75 dB

**Table 7.3.2.3.3-1b: UE multi-band relaxation factors for power class 3 (Rel-16 and forward)**

Band	$\Delta MB_{P,n}$ (dB)	$\Delta MB_{S,n}$ (dB)
n257	0.7 <sup>3</sup>	0.7 <sup>3</sup>
n258	0.6	0.7
n259	0.5	0.4
n260	0.5 <sup>1</sup>	0.4 <sup>1</sup>
n261	0.5 <sup>2,4</sup>	0.7 <sup>4</sup>
NOTE 1: n260 peak and spherical relaxations are 0 dB for UE that exclusively supports n261+n260		
NOTE 2: n261 peak relaxation is 0 dB for UE that exclusively supports n261+n260		
NOTE 3: n257 peak and spherical relaxations are 0 dB for UE that exclusively supports n261+n257		
NOTE 4: n261 peak and spherical relaxations are 0 dB for UE that exclusively supports n261+n257		

The REFSENS requirement shall be met for an uplink transmission using QPSK DFT-s-OFDM waveforms and for uplink transmission bandwidth less than or equal to that specified in Table 7.3.2.3.1-2.

Unless given by Table 7.3.2.3.1-3, the minimum requirements for reference sensitivity shall be verified with the network signalling value NS\_200 (Table 6.2.3.3.1-1) configured.

#### 7.3.2.3.4 Reference sensitivity power level for power class 4

The throughput shall be  $\geq 95\%$  of the maximum throughput of the reference measurement channels as specified in Annex A.2.3.2 and A.3.3.2 (with one sided dynamic OCNG Pattern OP.1 TDD for the DL-signal as described in Annex A.5.2.1) with peak reference sensitivity specified in Table 7.3.2.3.4-1. The requirement is verified with the test metric of EIS (Link=RX beam peak direction, Meas=Link Angle).

**Table 7.3.2.3.4-1: Reference sensitivity for power class 4**

Operating band	REFSENS (dBm) / Channel bandwidth			
	50 MHz	100 MHz	200 MHz	400 MHz
n257	-97.0	-94.0	-91.0	-88.0
n258	-97.0	-94.0	-91.0	-88.0
n260	-95.0	-92.0	-89.0	-86.0
n261	-97.0	-94.0	-91.0	-88.0
NOTE 1: The transmitter shall be set to $P_{UMAX}$ as defined in subclause 6.2.4				

The REFSENS requirement shall be met for an uplink transmission using QPSK DFT-s-OFDM waveforms and for uplink transmission bandwidth less than or equal to that specified in Table 7.3.2.3.1-2.

Unless given by Table 7.3.2.3.1-3, the minimum requirements for reference sensitivity shall be verified with the network signalling value NS\_200 (Table 6.2.3.3.1-1) configured.

The normative reference for this requirement is TS 38.101-2 [3] clause 7.3.2.

#### 7.3.2.4 Test description

##### 7.3.2.4.1 Initial conditions

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, test channel bandwidths and sub-carrier spacing based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each combination of channel bandwidth and subcarrier spacing are shown in Table 7.3.2.4.1-1, Table 7.3.2.4.1-2, and Table 7.3.2.4.1-3 The details of the uplink and downlink reference measurement

channels (RMCs) are specified in Annexes A.2 and A.3. The details of the OCNG patterns used are specified in Annex A.5. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 7.3.2.4.1-1: Test Configuration Table**

Initial Conditions				
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal, TL, TH	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1			Low range, Mid range, High range	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1			Lowest, 100MHz, Highest	
Test SCS as specified in Table 5.3.5-1			120kHz	
Test Parameters				
Test ID	Downlink Configuration		Uplink Configuration	
	Modulation	RB allocation	Modulation	RB allocation
1	CP-OFDM QPSK	Full RB (NOTE 1)	DFT-s-OFDM QPSK	REFSENS (NOTE 2)
NOTE 1: Full RB allocation shall be used per each SCS and channel BW as specified in Table 7.3.2.4.1-2.				
NOTE 2: REFSENS refers to Table 7.3.2.4.1-3 which defines uplink RB configuration and start RB location for each SCS, channel BW and NR band.				

**Table 7.3.2.4.1-2: Downlink Configuration of each RB allocation**

Channel Bandwidth	SCS kHz	LCRBmax	RB allocation (LCRB@RBstart)
50MHz	120	32	32@0
100MHz	120	66	66@0
200MHz	120	132	132@0
400MHz	120	264	264@0
NOTE 1: Test Channel Bandwidths are checked separately for each NR band, the applicable channel bandwidths are specified in Table 5.3.5-1.			

**Table 7.3.2.4.1-3: Uplink configuration for reference sensitivity, LCRB@RBstart format**

Operating Band	SCS kHz	50 MHz	100 MHz	200 MHz	400 MHz	Duplex Mode
n257	120	32@0	64@0	128@0	256@0	TDD
n258	120	32@0	64@0	128@0	256@0	TDD
n260	120	32@0	64@0	128@0	256@0	TDD
n261	120	32@0	64@0	128@0	256@0	TDD

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The DL and UL Reference Measurement channels are set according to Table 7.3.2.4.1-1, Table 7.3.2.4.1-2, and Table 7.3.2.4.1-3.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in State RRC\_CONNECTED with generic procedure parameters Connectivity NR, Connected without release On, Test Mode On and Test Loop Function On according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 7.3.2.4.3.

7.3.2.4.2 Test procedure

1. SS transmits PDSCH via PDCCH DCI format 1\_1 for C\_RNTI to transmit the DL RMC according to Table 7.3.2.4.1-1. The SS sends downlink MAC padding bits on the DL RMC.
2. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Tables 7.3.2.4.1-1. Since the UE has no payload data to send, the UE transmits uplink MAC padding bits on the UL RMC.
3. Send continuously uplink power control "up" commands in every uplink scheduling information to the UE; allow at least 200msec for the UE to reach P<sub>UMAX</sub>.
4. Set the UE in the Rx beam peak direction found with a 3D EIS scan as performed in Annex K.1.2. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Rx beam selection to complete.
5. Perform EIS procedure as stated in Annex K.1.4 to calculate "averaged EIS". At each power level, by changing the power level of the wanted signal with a step size of 0.2dB (coarse and fine searches are not precluded as long as the fine search is using the 0.2dB step size near the sensitivity level). For each power step measure the average throughput for a duration sufficient to achieve statistical significance according to Annex H.2. The downlink power step size shall be no more than 0.2 dB when the RF power level is near the sensitivity level.
6. Compare the dB value of the "averaged EIS" value corresponding to the Rx beam peak direction identified in step 5 to the test requirement in Table 7.3.2.5-1 to Table 7.3.2.5-4. If the EIS value is lower or equal to the value in Table 7.3.2.5-1 to Table 7.3.2.5-4, pass the UE. Otherwise fail the UE.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.2.

7.3.2.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with TRANSFORM\_PRECODER\_ENABLED condition in Table 4.6.3-118 PUSCH-Config.

7.3.2.5 Test requirement

The throughput shall be ≥ 95% of the maximum throughput of the reference measurement channels as specified in A.2.3.2 and A.3.3.2 (with one sided dynamic OCNG Pattern OP.1 TDD for the DL-signal as described in Annex A.5.2.1) with peak reference sensitivity specified in Tables 7.3.2.5-1 to 7.3.2.5-4. The requirement is verified with the test metric of EIS (Link=RX beam peak direction, Meas=Link Angle).

**Table 7.3.2.5-1: Reference sensitivity for power class 1**

Operating band	REFSENS (dBm) / Channel bandwidth			
	50 MHz	100 MHz	200 MHz	400 MHz
n257	-97.5+TT	-94.5+TT	-91.5+TT	-88.5+TT
n258	-97.5+TT	-94.5+TT	-91.5+TT	-88.5+TT
n260	-94.5+TT	-91.5+TT	-88.5+TT	-85.5+TT
n261	-97.5+TT	-94.5+TT	-91.5+TT	-88.5+TT

**Table 7.3.2.5-1a: Test Tolerance (Reference sensitivity for power class 1)**

Test Metric	FR2a
IFF (Max device size ≤ 30 cm)	[2.51] dB , NTC TBD dB , ETC

**Table 7.3.2.5-2: Reference sensitivity for power class 2**

Operating band	REFSENS (dBm) / Channel bandwidth			
	50 MHz	100 MHz	200 MHz	400 MHz
n257	-92+TT	-89+TT	-86+TT	-83+TT
n258	-92+TT	-89+TT	-86+TT	-83+TT
n261	-92+TT	-89+TT	-86+TT	-83+TT

**Table 7.3.2.5-3: Reference sensitivity for power class 3 for single band UE or multi-band UE declaring  $MB_p = 0$  in all FR2 bands**

Operating band	REFSENS (dBm) / Channel bandwidth			
	50 MHz	100 MHz	200 MHz	400 MHz
n257	-88.3+TT	-85.3+TT	-82.3+TT	-79.3+TT
n258	-88.3+TT	-85.3+TT	-82.3+TT	-79.3+TT
n259	-84.7+TT	-81.7+TT	-78.7+TT	-75.7+TT
n260	-85.7+TT	-82.7+TT	-79.7+TT	-76.7+TT
n261	-88.3+TT	-85.3+TT	-82.3+TT	-79.3+TT

**Table 7.3.2.5-3a: Reference sensitivity for power class 3 for multi-band UE declaring  $MB_p > 0$  in any FR2 band (Rel-15)**

Operating band	REFSENS (dBm) / Channel bandwidth (NOTE 1)			
	50 MHz	100 MHz	200 MHz	400 MHz
n257	-88.3+TT+ $MB_p$	-85.3+TT+ $MB_p$	-82.3+TT+ $MB_p$	-79.3+TT+ $MB_p$
n258	-88.3+TT+ $MB_p$	-85.3+TT+ $MB_p$	-82.3+TT+ $MB_p$	-79.3+TT+ $MB_p$
n260	-85.7+TT+ $MB_p$	-82.7+TT+ $MB_p$	-79.7+TT+ $MB_p$	-76.7+TT+ $MB_p$
n261	-88.3+TT+ $MB_p$	-85.3+TT+ $MB_p$	-82.3+TT+ $MB_p$	-79.3+TT+ $MB_p$

NOTE 1: Refer Table 7.3.2.5-3b for details for  $MB_p$  allowance corresponding to supported FR2 bands set

NOTE 2: For a Rel-15 UE supporting FR2 bands set not defined in Table 7.3.2.3.3-1a, Table 7.3.2.5-3c applies.

**Table 7.3.2.5-3b: Reference sensitivity multi-band relaxation factors for power class 3 (Rel-15)**

ID	Supported FR2 bands set	Maximum sum of $MB_p$ , $\sum MB_p$ (dB) (Note 3)	Comments
1	n257, n258	1.3	Maximum 0.75 dB relaxation allowed for each band
2	n257, n260	1.0	Maximum 0.75 dB relaxation allowed for each band
3	n258, n260	1.0	Maximum 0.75 dB relaxation allowed for each band
4	n258, n261	1.0	Maximum 0.75 dB relaxation allowed for each band
5	n260, n261	0.0	No relaxation factor allowed
6	n257, n258, n260	1.7	Maximum 0.75 dB relaxation allowed for each band
7	n257, n258, n261	1.7	Maximum 0.75 dB relaxation allowed for each band
8	n257, n260, n261	0.5	Maximum 0.75 dB relaxation allowed for each band
9	n258, n260, n261	1.5	Maximum 0.75 dB relaxation allowed for each band
10	n257, n258, n260, n261	1.7	Maximum 0.75 dB relaxation allowed for each band

NOTE 1:  $MB_p$  is the Multiband Relaxation factor declared by the UE for the tested band in table A.4.3.9-2 of TS38.508-2. This declaration shall fulfil the requirements in Table 7.3.2.3.3-1a.

NOTE 2: All UE supported bands needs to be tested to ensure the multiband relaxation declaration is compliant

NOTE 3: Max allowed sum of  $MB_p$  over all supported FR2 bands as defined in clause 7.3.2.3.3.

**Table 7.3.2.5-3c: Reference sensitivity for power class 3 (Rel-16 and forward)**

Operating band	REFSENS (dBm) / Channel bandwidth (NOTE 1)			
	50 MHz	100 MHz	200 MHz	400 MHz
n257	-88.3+TT+ $\Delta MB_{P,n}$	-85.3+TT+ $\Delta MB_{P,n}$	-82.3+TT+ $\Delta MB_{P,n}$	-79.3+TT+ $\Delta MB_{P,n}$
n258	-88.3+TT+ $\Delta MB_{P,n}$	-85.3+TT+ $\Delta MB_{P,n}$	-82.3+TT+ $\Delta MB_{P,n}$	-79.3+TT+ $\Delta MB_{P,n}$
n259	-84.7+TT+ $\Delta MB_{P,n}$	-81.7+TT+ $\Delta MB_{P,n}$	-78.7+TT+ $\Delta MB_{P,n}$	-75.7+TT+ $\Delta MB_{P,n}$
n260	-85.7+TT+ $\Delta MB_{P,n}$	-82.7+TT+ $\Delta MB_{P,n}$	-79.7+TT+ $\Delta MB_{P,n}$	-76.7+TT+ $\Delta MB_{P,n}$

n261	-88.3+TT+ $\Delta$ MB <sub>P,n</sub>	-85.3+TT+ $\Delta$ MB <sub>P,n</sub>	-82.3+TT+ $\Delta$ MB <sub>P,n</sub>	-79.3+TT+ $\Delta$ MB <sub>P,n</sub>
NOTE 1: Refer Table 7.3.2.5-3d for details for $\Delta$ MB <sub>P,n</sub> allowance corresponding to supported FR2 bands set				

**Table 7.3.2.5-3d: Reference sensitivity multi-band relaxation factors for power class 3 (Rel-16 and forward)**

ID	FR2 bands/set	$\Delta$ MB <sub>P,n</sub> (dB)	Comments
1	n257	0.7	
2	n258	0.6	
3	n259	0.5	
4	n260	0.5	
5	n261	0.5	
6	n257, n261	0	$\Delta$ MB <sub>P,n</sub> relaxation is 0 dB
7	n260, n261	0	$\Delta$ MB <sub>P,n</sub> relaxation is 0 dB
NOTE 1: $\Delta$ MB <sub>P,n</sub> is the Multiband Relaxation factor for the tested band. This shall fulfil the requirements in Table 7.3.2.3.3-1b.			

**Table 7.3.2.5-3e: Test Tolerance (Reference sensitivity for power class 3)**

Test Metric	f ≤ 40.8 GHz
IFF (Max device size ≤ 30 cm)	2.34 dB, NTC 2.45 dB, ETC

**Table 7.3.2.5-4: Reference sensitivity for power class 4**

Operating band	REFSENS (dBm) / Channel bandwidth			
	50 MHz	100 MHz	200 MHz	400 MHz
n257	-97+TT	-94+TT	-91+TT	-88+TT
n258	-97+TT	-94+TT	-91+TT	-88+TT
n260	-95+TT	-92+TT	-89+TT	-86+TT
n261	-97+TT	-94+TT	-91+TT	-88+TT

## 7.3.4 EIS spherical coverage

**Editor's Note:** The following aspects are either missing or not yet determined:

- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.
- The test case is incomplete for band n259.

### 7.3.4.1 Test purpose

To verify that the EIS spherical coverage of the UE receiver is acceptable under conditions of low signal level, ideal propagation and no added noise.

### 7.3.4.2 Test applicability

This test case applies to all types of NR UE release 15 and forward.

### 7.3.4.3 Minimum conformance requirements

The reference sensitivity power level REFSENS at a single grid point of the spherical grid is the minimum mean power applied to each one of the UE antenna ports for all UE categories, at which the throughput shall meet or exceed the requirements for the specified reference measurement channel.

The reference measurement channels and throughput criterion shall be as specified in section 7.3.2.3.



For power class 1, the maximum EIS at the 85<sup>th</sup> percentile of the CCDF of EIS measured over the full sphere around the UE is defined as the spherical coverage requirement and is found in Table 7.3.4.3-1 below. The requirement is verified with the test metric of EIS (Link=Spherical coverage grid, Meas=Link angle).

**Table 7.3.4.3-1: EIS spherical coverage for power class 1**

Operating band	EIS at 85 <sup>th</sup> ile CCDF (dBm) / Channel bandwidth			
	50 MHz	100 MHz	200 MHz	400 MHz
n257	-89.5	-86.5	-83.5	-80.5
n258	-89.5	-86.5	-83.5	-80.5
n260	-86.5	-83.5	-80.5	-77.5
n261	-89.5	-86.5	-83.5	-80.5

NOTE 1: The transmitter shall be set to P<sub>UMAX</sub> as defined in subclause 6.2.4.  
NOTE 2: The EIS spherical coverage requirements are verified only under normal thermal conditions as defined in TS 38.508-1 [10] subclause 4.1.1.

For power class 2, the maximum EIS at the 60<sup>th</sup> percentile of the CCDF of EIS measured over the full sphere around the UE is defined as the spherical coverage requirement and is found in Table 7.3.4.3-2 below. The requirement is verified with the test metric of EIS (Link=Spherical coverage grid, Meas=Link angle).

**Table 7.3.4.3-2: EIS spherical coverage for power class 2**

Operating band	EIS at 60 <sup>th</sup> ile CCDF (dBm) / Channel bandwidth			
	50 MHz	100 MHz	200 MHz	400 MHz
n257	-81	-78	-75	-72
n258	-81	-78	-75	-72
n261	-81	-78	-75	-72

NOTE 1: The transmitter shall be set to P<sub>UMAX</sub> as defined in subclause 6.2.4.  
NOTE 2: The EIS spherical coverage requirements are verified only under normal thermal conditions as defined in TS 38.508-1 [10] subclause 4.1.1.

For power class 3, the maximum EIS at the 50<sup>th</sup> percentile of the CCDF of EIS measured over the full sphere around the UE is defined as the spherical coverage requirement and is found in Table 7.3.4.3-3 below. The requirement is verified with the test metric of EIS (Link=Spherical coverage grid, Meas=Link angle).

For power class 3, the UEs that support operation in multiple FR2 bands, the minimum requirement for EIS spherical coverage in Table 7.3.4.3-3 shall be increased per band, respectively, by the reference sensitivity relaxation parameter  $\Sigma_{MB_S}$  and  $\Delta_{MB_{S,n}}$  as specified in Table 7.3.2.3.3-1a and 7.3.2.3.3-1b..

**Table 7.3.4.3-3: EIS spherical coverage for power class 3**

Operating band	EIS at 50 <sup>th</sup> ile CCDF (dBm) / Channel bandwidth			
	50 MHz	100 MHz	200 MHz	400 MHz
n257	-77.4	-74.4	-71.4	-68.4
n258	-77.4	-74.4	-71.4	-68.4
n259	-71.9	-68.9	-65.9	-62.9
n260	-73.1	-70.1	-67.1	-64.1
n261	-77.4	-74.4	-71.4	-68.4

NOTE 1: The transmitter shall be set to P<sub>UMAX</sub> as defined in subclause 6.2.4  
NOTE 2: The EIS spherical coverage requirements are verified only under normal thermal conditions as defined in TS 38.508-1 [10] subclause 4.1.1.

For power class 4, the maximum EIS at the 20<sup>th</sup> percentile of the CCDF of EIS measured over the full sphere around the UE is defined as the spherical coverage requirement and is found in Table 7.3.4.3-4 below. The requirement is verified with the test metric of EIS (Link=Spherical coverage grid, Meas=Link angle).

**Table 7.3.4.3-4: EIS spherical coverage for power class 4**

Operating band	EIS at 20 <sup>th</sup> ile CCDF (dBm) / Channel bandwidth			
	50 MHz	100 MHz	200 MHz	400 MHz
n257	-88.0	-85.0	-82.0	-79.0
n258	-88.0	-85.0	-82.0	-79.0

n260	-83.0	-80.0	-77.0	-74.0
n261	-88.0	-85.0	-82.0	-79.0
NOTE 1: The transmitter shall be set to $P_{UMAX}$ as defined in subclause 6.2.4				
NOTE 2: The EIS spherical coverage requirements are verified only under normal thermal conditions as defined in TS 38.508-1 [10] subclause 4.1.1.				

The REFSENS requirement shall be met for an uplink transmission using QPSK DFT-s-OFDM waveforms and for uplink transmission bandwidth less than or equal to that specified in Table 7.3.4.3-5.

**Table 7.3.4.3-5: Uplink configuration for reference sensitivity**

NR Band / Channel bandwidth / $N_{RB}$ / SCS / Duplex mode						
NR Band	50 MHz	100 MHz	200 MHz	400 MHz	SCS	Duplex Mode
n257	32	64	128	256	120 kHz	TDD
n258	32	64	128	256	120 kHz	TDD
n260	32	64	128	256	120 kHz	TDD
n261	32	64	128	256	120 kHz	TDD

Unless given by Table 7.3.4.3-6, the minimum requirements specified in Table 7.3.4.3-1, Table 7.3.4.3-2, Table 7.3.4.3-3 and Table 7.3.4.3-4 shall be verified with the network signalling value NS\_200 configured.

**Table 7.3.4.3-6: Network Signalling value for reference sensitivity**

NR Band	Network Signalling value
n258	NS_201

For the UE which supports inter-band carrier aggregation, the minimum requirement for reference sensitivity in Table 7.3.4.3-1, Table 7.3.4.3-2, Table 7.3.4.3-3 and Table 7.3.4.3-4 shall be increased by the amount given in  $\Delta R_{IB,P,n}$  defined in subclause 7.3A.2.0.3 for the applicable operating bands.

The normative reference for this requirement is TS 38.101-2 [3] clause 7.3.4.

#### 7.3.4.4 Test description

##### 7.3.4.4.1 Initial conditions

Same initial conditions as in clause 7.3.2.4.1 except that only normal condition is tested.

##### 7.3.4.4.2 Test procedure

1. SS transmits PDSCH via PDCCH DCI format 1\_1 for  $C_{RNTI}$  to transmit the DL RMC according to Table 7.3.2.4.1-1. The SS sends downlink MAC padding bits on the DL RMC.
2. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for  $C_{RNTI}$  to schedule the UL RMC according to Tables 7.3.2.4.1-1. Since the UE has no payload data to send, the UE transmits uplink MAC padding bits on the UL RMC.
3. Send continuously uplink power control "up" commands in every uplink scheduling information to the UE; allow at least 200msec for the UE to reach  $P_{UMAX}$ .
4. Set the UE in the Rx beam peak direction found with a 3D EIS scan as performed in Annex K.1.2. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Rx beam selection to complete.
5. Measure UE EIS value for each grid point according to EIS spherical coverage procedure defined in Annex K.1.6.0, and obtain a Complimentary Cumulative Distribution Function (CCDF) of all EIS dBm values. Alternatively, UE EIS measurement for each grid point could be done according to Rx Fast spherical coverage procedure defined in Annex K.1.6.1. After a rotation, allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for UE to find the best beam to use. EIS is calculated considering both polarizations, theta and phi.

6. Identify the EIS dBm value corresponding to %-tile (UE power class dependent) value in the applicable test requirement table in section 7.3.4.5.
7. Compare the EIS dBm value identified in step 6, to the limit value in the applicable test requirement table in section 7.3.4.5. If the EIS dBm value is lower or equal to the limit value, pass the UE. Otherwise fail the UE.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.2.

#### 7.3.4.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with TRANSFORM\_PRECODER\_ENABLED condition in Table 4.6.3-118 PUSCH-Config.

#### 7.3.4.5 Test requirement

The reference measurement channels and throughput criterion shall be as specified in section 7.3.2.5.

**Table 7.3.4.5-1: EIS spherical coverage for power class 1**

Operating band	EIS at 85 <sup>th</sup> ile CCDF (dBm) / Channel bandwidth			
	50 MHz	100 MHz	200 MHz	400 MHz
n257	-89.5 +TT	-86.5 +TT	-83.5 +TT	-80.5 +TT
n258	-89.5 +TT	-86.5 +TT	-83.5 +TT	-80.5 +TT
n260	-86.5 +TT	-83.5 +TT	-80.5 +TT	-77.5 +TT
n261	-89.5 +TT	-86.5 +TT	-83.5 +TT	-80.5 +TT

NOTE 1: The transmitter shall be set to P<sub>UMAX</sub> as defined in subclause 6.2.4.  
NOTE 2: The EIS spherical coverage requirements are verified only under normal thermal conditions as defined in TS 38.508-1 [10] subclause 4.1.1.

**Table 7.3.4.5-2: EIS spherical coverage for power class 2**

Operating band	EIS at 60 <sup>th</sup> ile CCDF (dBm) / Channel bandwidth			
	50 MHz	100 MHz	200 MHz	400 MHz
n257	-81 +TT	-78 +TT	-75 +TT	-72 +TT
n258	-81 +TT	-78 +TT	-75 +TT	-72 +TT
n261	-81 +TT	-78 +TT	-75 +TT	-72 +TT

NOTE 1: The transmitter shall be set to P<sub>UMAX</sub> as defined in subclause 6.2.4.  
NOTE 2: The EIS spherical coverage requirements are verified only under normal thermal conditions as defined in TS 38.508-1 [10] subclause 4.1.1.

**Table 7.3.4.5-3: EIS spherical coverage for power class 3 for single band UE or multi-band UE declaring MB<sub>s</sub> = 0 in all FR2 bands**

Operating band	EIS at 50 <sup>th</sup> ile CCDF (dBm) / Channel bandwidth			
	50 MHz	100 MHz	200 MHz	400 MHz
n257	-77.4 +TT	-74.4 +TT	-71.4 +TT	-68.4 +TT
n259	-71.9 +TT	-68.9 +TT	-65.9 +TT	-62.9 +TT
n258	-77.4 +TT	-74.4 +TT	-71.4 +TT	-68.4 +TT
n260	-73.1 +TT	-70.1 +TT	-67.1 +TT	-64.1 +TT
n261	-77.4 +TT	-74.4 +TT	-71.4 +TT	-68.4 +TT

NOTE 1: The transmitter shall be set to P<sub>UMAX</sub> as defined in subclause 6.2.4.  
NOTE 2: The EIS spherical coverage requirements are verified only under normal thermal conditions as defined in TS 38.508-1 [10] subclause 4.1.1.

**Table 7.3.4.5-3a: EIS spherical coverage for power class 3 for multi-band UE declaring MB<sub>s</sub> > 0 in any FR2 band (Rel-15)**

Operating band	EIS at 50 <sup>th</sup> ile CCDF (dBm) / Channel bandwidth (NOTE 3)			
	50 MHz	100 MHz	200 MHz	400 MHz
n257	-77.4 +TT+MB <sub>s</sub>	-74.4 +TT+MB <sub>s</sub>	-71.4 +TT+MB <sub>s</sub>	-68.4 +TT+MB <sub>s</sub>
n258	-77.4 +TT+MB <sub>s</sub>	-74.4 +TT+MB <sub>s</sub>	-71.4 +TT+MB <sub>s</sub>	-68.4 +TT+MB <sub>s</sub>

n260	-73.1 +TT+MB <sub>s</sub>	-70.1 +TT+MB <sub>s</sub>	-67.1 +TT+MB <sub>s</sub>	-64.1 +TT+MB <sub>s</sub>
n261	-77.4 +TT+MB <sub>s</sub>	-74.4 +TT+MB <sub>s</sub>	-71.4 +TT+MB <sub>s</sub>	-68.4 +TT+MB <sub>s</sub>
NOTE 1: The transmitter shall be set to P <sub>UMAX</sub> as defined in subclause 6.2.4. NOTE 2: The EIS spherical coverage requirements are verified only under normal thermal conditions as defined in TS 38.508-1 [10] subclause 4.1.1. NOTE 3: Refer Table 7.3.4.5-3b for details for MB <sub>s</sub> allowance corresponding to supported FR2 band set combination NOTE 4: For a Rel-15 UE supporting FR2 bands set not defined in Table 7.3.2.3.3-1a, Table 7.3.4.5-3c applies.				

**Table 7.3.4.5-3b: EIS spherical coverage multiband relaxation factors for power class 3 (Rel-15)**

ID	Supported FR2 bands set	Maximum sum of MB <sub>s</sub> , $\sum$ MB <sub>s</sub> (dB) (Note 3)	Comments
1	n257, n258	1.25	Maximum 0.75 dB relaxation allowed for each band
2	n257, n260	0.75	Maximum 0.4 dB relaxation allowed for n260 and 0.75 dB relaxation allowed for all other bands
3	n258, n260	0.75	Maximum 0.4 dB relaxation allowed for n260 and 0.75 dB relaxation allowed for all other bands
4	n258, n261	1.25	Maximum 0.75 dB relaxation allowed for each band
5	n260, n261	0.75	No relaxation allowed for n260 and 0.75 dB relaxation allowed for all other bands
6	n257, n258, n260	1.75	Maximum 0.4 dB relaxation allowed for n260 and 0.75 dB relaxation allowed for all other bands
7	n257, n258, n261	1.75	Maximum 0.75 dB relaxation allowed for each band
8	n257, n260, n261	1.25	Maximum 0.4 dB relaxation allowed for n260 and 0.75 dB relaxation allowed for all other bands
9	n258, n260, n261	1.25	Maximum 0.4 dB relaxation allowed for n260 and 0.75 dB relaxation allowed for all other bands
10	n257, n258, n260, n261	1.75	Maximum 0.4 dB relaxation allowed for n260 and 0.75 dB relaxation allowed for all other bands
NOTE 1: MB <sub>s</sub> is the Multiband Relaxation factor declared by the UE for the tested band in Table A.4.3.9-3 of TS38.508-2 [11]. This declaration shall fulfil the requirements in Table 7.3.2.3.3-1a. NOTE 2: All UE supported bands needs to be tested to ensure the multiband relaxation declaration is compliant NOTE 3: Max allowed sum of MB <sub>s</sub> over all supported FR2 bands as defined in clause 7.3.2.3.3.			

**Table 7.3.4.5-3c: EIS spherical coverage for power class 3 (Rel-16 and forward)**

Operating band	EIS at 50 <sup>th</sup> ile CCDF (dBm) / Channel bandwidth (NOTE 3)			
	50 MHz	100 MHz	200 MHz	400 MHz
n257	-77.4 +TT+ΔMB <sub>s,n</sub>	-74.4 +TT+ΔMB <sub>s,n</sub>	-71.4 +TT+ΔMB <sub>s,n</sub>	-68.4 +TT+ΔMB <sub>s,n</sub>
n258	-77.4 +TT+ΔMB <sub>s,n</sub>	-74.4 +TT+ΔMB <sub>s,n</sub>	-71.4 +TT+ΔMB <sub>s,n</sub>	-68.4 +TT+ΔMB <sub>s,n</sub>
n259	-71.9 +TT+ΔMB <sub>s,n</sub>	-68.9 +TT+ΔMB <sub>s,n</sub>	-65.9 +TT+ΔMB <sub>s,n</sub>	-62.9 +TT+ΔMB <sub>s,n</sub>
n260	-73.1 +TT+ΔMB <sub>s,n</sub>	-70.1 +TT+ΔMB <sub>s,n</sub>	-67.1 +TT+ΔMB <sub>s,n</sub>	-64.1 +TT+ΔMB <sub>s,n</sub>
n261	-77.4 +TT+ΔMB <sub>s,n</sub>	-74.4 +TT+ΔMB <sub>s,n</sub>	-71.4 +TT+ΔMB <sub>s,n</sub>	-68.4 +TT+ΔMB <sub>s,n</sub>
NOTE 1: The transmitter shall be set to P <sub>UMAX</sub> as defined in subclause 6.2.4. NOTE 2: The EIS spherical coverage requirements are verified only under normal thermal conditions as defined in TS 38.508-1 [10] subclause 4.1.1. NOTE 3: Refer Table 7.3.4.5-3d for details for MB <sub>s</sub> allowance corresponding to supported FR2 band set combination				

**Table 7.3.4.5-3d: EIS spherical coverage multi-band relaxation factors for power class 3 (Rel-16 and forward)**

ID	FR2 bands/set	Comments
1	n257	
2	n258	
3	n259	
4	n260	
5	n261	
6	n257, n261	ΔMB <sub>s,n</sub> relaxation is 0 dB
7	n260, n261	ΔMB <sub>s,n</sub> relaxation is 0 dB

NOTE 1:  $MB_{s,n}$  is the Multiband Relaxation factor for the tested band. This shall fulfil the requirements in Table 7.3.2.3.3-1b.

**Table 7.3.4.5-3e: Test Tolerance (Reference sensitivity for power class 3)**

Test Metric	f ≤ 40.8 GHz
IFF (Max device size ≤ 30 cm)	2.21 dB

**Table 7.3.4.5-4: EIS spherical coverage for power class 4**

Operating band	EIS at 20 <sup>th</sup> ile CCDF (dBm) / Channel bandwidth			
	50 MHz	100 MHz	200 MHz	400 MHz
n257	-88.0 +TT	-85.0 +TT	-82.0 +TT	-79.0 +TT
n258	-88.0 +TT	-85.0 +TT	-82.0 +TT	-79.0 +TT
n260	-83.0 +TT	-80.0 +TT	-77.0 +TT	-74.0 +TT
n261	-88.0 +TT	-85.0 +TT	-82.0 +TT	-79.0 +TT

NOTE 1: The transmitter shall be set to  $P_{UMAX}$  as defined in subclause 6.2.4  
NOTE 2: The EIS spherical coverage requirements are verified only under normal thermal conditions as defined in TS 38.508-1 [10] subclause 4.1.1.

## 7.3A Reference sensitivity for CA

### 7.3A.1 General

The reference sensitivity power level REFSENS for both Intra-band non-contiguous CA and Intra-band contiguous CA is defined as the EIS level at the centre of the quiet zone in the RX beam peak direction[(same as that found for single carrier scenario in clause 7.3.2)], at which the throughput shall meet or exceed the requirements for the specified reference measurement channel.

### 7.3A.2 Reference sensitivity power level for CA

#### 7.3A.2.0 Minimum Conformance Requirements

##### 7.3A.2.0.1 Intra-band contiguous CA

For each component carrier in the intra-band contiguous carrier aggregation, the throughput in QPSK  $R = 1/3$  shall be  $\geq 95\%$  of the maximum throughput of the reference measurement channels as specified in Annex A (with one sided dynamic OCNG Pattern OP.1 TDD for the DL-signal) with peak reference sensitivity values determined from section 7.3.2.3, and relaxation applied to peak reference sensitivity requirement as specified in Table 7.3A.2.0.1-1.

**Table 7.3A.2.0.1-1:  $\Delta R_{IB}$  EIS Relaxation for CA operation by aggregated channel bandwidth**

Aggregated Channel BW 'BW <sub>Channel_CA</sub> ' (MHz)	$\Delta R_{IB}$ (dB)
$BW_{Channel\_CA} \leq 800$	0.0
$800 < BW_{Channel\_CA} \leq 1200$	0.5

The normative reference for this requirement is TS 38.101-2 [3] clause 7.3A.2.1.

##### 7.3A.2.0.2 Intra-band non-contiguous CA

For each component carrier in the intra-band non-contiguous carrier aggregation, the throughput in QPSK  $R=1/3$  shall be  $\geq 95\%$  of the maximum throughput of the reference measurement channels as specified in Annex A (with one sided dynamic OCNG Pattern OP.1 TDD for the DL-signal) with peak reference sensitivity values determined from section 7.3.2.3, and relaxation applied to peak reference sensitivity requirement as specified in Table 7.3A.2.0.2-1. The

configured downlink spectrum is defined as the frequency band from the lowest edge of the lowest CC to the upper edge of the highest CC of all DL configured CCs.

**Table 7.3A.2.0.2-1:  $\Delta R_{IB}$  EIS Relaxation for CA operation by cumulative aggregated channel bandwidth**

Cumulative Aggregated Channel BW (MHz)	$\Delta R_{IB}$ (dB)
$\leq 800$	0.0
$> 800$ and $\leq 1400$	0.5
$> 1400$ and $\leq 2400$	1.5

The normative reference for this requirement is TS 38.101-2 [3] clause 7.3A.2.2.

### 7.3A.2.0.3 Inter-band CA

The inter-band requirement applies for all active component carriers. The throughput for each component carrier shall be  $\geq 95\%$  of the maximum throughput of the reference measurement channels as specified in Annexes A.2.3.2 and A.3.3.2 (with one sided dynamic OCNG Pattern OP.1 TDD for the DL-signal as described in Annex A.5.2.1) with peak reference sensitivity for each carrier specified in section 7.3.2, and relaxation  $\Delta R_{IB,P,n}$  applied to peak reference sensitivity requirement.  $\Delta R_{IB,P,n}$  is specified in Table 7.3A.2.0.3-1. The requirement on each component carrier shall be met when the power in the component carrier in the other band is set to its EIS spherical coverage requirement for inter-band CA specified in sub-clause 7.3A.3.3.

For the combination of intra-band and inter-band carrier aggregation, the intra-band CA relaxation,  $\Delta R_{IB}$ , is also applied according to the clause 7.3A.2.1 and 7.3A.2.2.

**Table 7.3A.2.0.3-1:  $\Delta R_{IB,P,n}$  reference sensitivity relaxation for inter-band CA for power class 3**

NR CA bands	NR band	$\Delta R_{IB,P,n}$ (dB)
CA_n260-n261	n260	3.5
	n261	3.5

### 7.3A.2.1 Reference sensitivity power level for CA (2DL CA)

**Editor's note:** The following aspects are either missing or not yet determined:

- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW  $> 400$  MHz and for intra-band non-contiguous CA are TBD.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.
- In case of frequency separation larger than 800 MHz and in case the device manufacturer does not explicitly declare that the beam peak for a reference (frequency band, CBW) or (frequency band combination, CA BW class) is applicable for a group of other intra-band contiguous combinations and CA BW classes, according to Table A.4.3.9-6 in 38.508-2, following aspect of beam peak search procedures for CA is FFS: RB allocation, power level, channel bandwidth configuration, per CC approach or all CC combined approach, etc
- Some references are in square brackets for inter-band DL CA

#### 7.3A.2.1.1 Test purpose

Same test purpose as in clause 7.3.2.1.

#### 7.3A.2.1.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 2DL CA.

#### 7.3A.2.1.3 Minimum conformance requirements

Same minimum conformance requirements as in clause 7.3A.2.0.

## 7.3A.2.1.4 Test description

## 7.3A.2.1.4.1 Initial conditions

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, test channel bandwidths and sub-carrier spacing based on NR CA configurations specified in clause 5.5A. All of these configurations shall be tested with applicable test parameters for each combination of channel bandwidth and subcarrier spacing are shown in Table 7.3A.2.1.4.1-1, Table 7.3A.2.1.4.1-2 and Table 7.3A.2.1.4.1-3. The details of the uplink and downlink reference measurement channels (RMCs) are specified in Annexes A.2 and A.3. The details of the OCNG patterns used are specified in Annex A.5. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 7.3A.2.1.4.1-1: Test Configuration Table**

Initial Conditions				
Test Environment as specified in TS 38.508-1 [10] subclause 4.1		Normal, TL, TH		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 and 4.3.1.2.4 for different CA bandwidth classes		Low range, High range		
Test CA Bandwidth combination as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 and 4.3.1.2.4 for the CA Configuration across bandwidth combination sets supported by the UE		Maximum aggregated BW (contiguous CA) or Maximum cumulative aggregated BW (non-contiguous CA)		
Test SCS as specified in Table 5.3.5-1		120kHz		
Test Parameters				
Test ID	Downlink Configuration		Uplink Configuration	
	Modulation	RB allocation	Modulation	RB allocation
1	CP-OFDM QPSK	Full RB (NOTE 1)	DFT-s-OFDM QPSK	REFSENS (NOTE 2, NOTE 3)
NOTE 1: Full RB allocation shall be used per each SCS and component carrier as specified in Table 7.3A.2.1.4.1-2.				
NOTE 2: REFSENS refers to Table 7.3A.2.1.4.1-3 which defines uplink RB configuration and start RB location for each SCS, channel BW.				
NOTE 3: Use single carrier UL when testing reference sensitivity power level for CA. The PCC is located on the CC with the lowest carrier frequency.				

**Table 7.3A.2.1.4.1-2: Downlink Configuration of each RB allocation**

Component Carrier Bandwidth	SCS kHz	LCRBmax	RB allocation (LCRB@RBstart)
50MHz	120	32	32@0
100MHz	120	66	66@0
200MHz	120	132	132@0
400MHz	120	264	264@0
NOTE 1: CA Bandwidths are checked separately for each NR band, the applicable CA bandwidths are specified in Table 5.3A.4-1.			

**Table 7.3A.2.1.4.1-3: Uplink configuration for reference sensitivity, LCRB@RBstart format**

Operating Band	SCS kHz	50 MHz	100 MHz	200 MHz	400 MHz	Duplex Mode
n257	120	32@0	64@0	128@0	256@0	TDD
n258	120	32@0	64@0	128@0	256@0	TDD
n260	120	32@0	64@0	128@0	256@0	TDD
n261	120	32@0	64@0	128@0	256@0	TDD

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The UL Reference Measurement channels are set according to Table 7.3A.2.1.4.1-1, Table 7.3A.2.1.4.1-2 and Table 7.3A.2.1.4.1-3.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in State RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 7.3A.2.1.4.3.

#### 7.3A.2.1.4.2 Test Procedure

1. Configure SCC according to Annex C.0, C.1, C.2 for all downlink physical channels.
2. The SS shall configure SCC as per TS 38.508-1 [10] clause 5.5.1. Message contents are defined in clause 7.3A.2.1.4.3.
3. SS activates SCC by sending the activation MAC CE (Refer TS 38.321[28], clauses 5.9, 6.1.3.10). Wait for at least 2 seconds (Refer TS 38.133[25], clause 9.2).
4. SS transmits PDSCH via PDCCH DCI format 1\_1 for C\_RNTI to transmit the DL RMC according to Table 7.3A.2.1.4.1-1. The SS sends downlink MAC padding bits on the DL RMC.
5. SS sends uplink scheduling information on PCC for each UL HARQ process via PDCCH DCI format [0\_1] for C\_RNTI to schedule the UL RMC according to Table 7.3A.2.1.4.1-1. Since the UE has no payload data to send, the UE transmits uplink MAC padding bits on the UL RMC.
6. Send continuously uplink power control "up" commands in every uplink scheduling information to the UE; allow at least 200msec for the UE to reach  $P_{UMAX}$ .
7. Set the UE in the Rx beam peak direction found with a 3D EIS scan as performed in Annex K.1.2.. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Rx beam selection to complete.
8. For each component carrier, perform EIS procedure as stated in Annex K.1.4 to calculate "averaged EIS" by changing the power level of the wanted signal with a step size of 0.2dB, while increasing the power level of each component carrier other than the one being tested by a fixed offset of 5 dB compared to the current power level of the component carrier under test. Coarse and fine searches are not precluded as long as the fine search is using the 0.2dB step size near the sensitivity level. For each power step measure the average throughput for a duration sufficient to achieve statistical significance according to Annex H.2.
9. For each component carrier, compare the dB value of the "averaged EIS" value corresponding to the Rx beam peak direction (same as that found for single carrier in clause 7.3.2) identified in step 8 to the test requirement in Tables 7.3A.2.1.5-4 to Table 7.3A.2.1.5-7. If the EIS value is lower or equal to the value in Tables 7.3A.2.1.5-4 to Table 7.3A.2.1.5-7, pass the UE. Otherwise fail the UE.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.2.

#### 7.3A.2.1.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with TRANSFORM\_PRECODER\_ENABLED condition in Table 4.6.3-118 PUSCH-Config.

#### 7.3A.2.1.5 Test requirement

For each component carrier, the throughput shall be  $\geq 95\%$  of the maximum throughput of the reference measurement channels as specified in Annex A.2 and A.3 (with one sided dynamic OCNG Pattern OP.1 TDD for the DL-signal as described in Annex A.5) with peak reference sensitivity specified in Tables 7.3A.2.1.5-4 to 7.3A.2.1.5-7. The requirement is verified with the test metric of EIS (Link=RX beam peak direction, Meas=Link Angle).



Table 7.3A.2.1.5-1:  $\Delta R_{IB}$  EIS Relaxation per component carrier for intra-band contiguous CA

Aggregated Channel BW 'BW <sub>Channel_CA</sub> ' (MHz)	$\Delta R_{IB}$ (dB) / CC
$BW_{Channel\_CA} \leq 800$	0.0
$800 < BW_{Channel\_CA} \leq 1200$	0.5

Table 7.3A.2.1.5-2:  $\Delta R_{IB}$  EIS Relaxation per component carrier for intra-band non-contiguous CA

Cumulative Aggregated Channel BW (MHz)	$\Delta R_{IB}$ (dB) / CC
$\leq 800$	0.0
$> 800$ and $\leq 1400$	0.5
$> 1400$ and $\leq 2400$	1.5

Table 7.3A.2.1.5-3:  $\Delta R_{IB}$  reference sensitivity relaxation for inter-band CA for power class 3

NR CA bands	NR band	$\Delta R_{IB,P,n}$ (dB)
CA_n260-n261	n260	3.5
	n261	3.5

Table 7.3A.2.1.5-4: Reference sensitivity per component carrier for power class 1

Operating band	REFSENS (dBm) / CC			
	50 MHz	100 MHz	200 MHz	400 MHz
n257	$-97.5+TT+\Delta R_{IB}$	$-94.5+TT+\Delta R_{IB}$	$-91.5+TT+\Delta R_{IB}$	$-88.5+TT+\Delta R_{IB}$
n258	$-97.5+TT+\Delta R_{IB}$	$-94.5+TT+\Delta R_{IB}$	$-91.5+TT+\Delta R_{IB}$	$-88.5+TT+\Delta R_{IB}$
n260	$-94.5+TT+\Delta R_{IB}$	$-91.5+TT+\Delta R_{IB}$	$-88.5+TT+\Delta R_{IB}$	$-85.5+TT+\Delta R_{IB}$
n261	$-97.5+TT+\Delta R_{IB}$	$-94.5+TT+\Delta R_{IB}$	$-91.5+TT+\Delta R_{IB}$	$-88.5+TT+\Delta R_{IB}$

Table 7.3A.2.1.5-5: Reference sensitivity per component carrier for power class 2

Operating band	REFSENS (dBm) / CC			
	50 MHz	100 MHz	200 MHz	400 MHz
n257	$-94.5+TT+\Delta R_{IB}$	$-91.5+TT+\Delta R_{IB}$	$-88.5+TT+\Delta R_{IB}$	$-85.5+TT+\Delta R_{IB}$
n258	$-94.5+TT+\Delta R_{IB}$	$-91.5+TT+\Delta R_{IB}$	$-88.5+TT+\Delta R_{IB}$	$-85.5+TT+\Delta R_{IB}$
n260				
n261	$-94.5+TT+\Delta R_{IB}$	$-91.5+TT+\Delta R_{IB}$	$-88.5+TT+\Delta R_{IB}$	$-85.5+TT+\Delta R_{IB}$

Table 7.3A.2.1.5-6: Reference sensitivity per component carrier for power class 3

Operating band	REFSENS (dBm) / Channel bandwidth			
	50 MHz	100 MHz	200 MHz	400 MHz
n257	$-88.3+TT+\Delta R_{IB}$	$-85.3+TT+\Delta R_{IB}$	$-82.3+TT+\Delta R_{IB}$	$-79.3+TT+\Delta R_{IB}$
n258	$-88.3+TT+\Delta R_{IB}$	$-85.3+TT+\Delta R_{IB}$	$-82.3+TT+\Delta R_{IB}$	$-79.3+TT+\Delta R_{IB}$
n260	$-85.7+TT+\Delta R_{IB}$	$-82.7+TT+\Delta R_{IB}$	$-79.7+TT+\Delta R_{IB}$	$-76.7+TT+\Delta R_{IB}$
n261	$-88.3+TT+\Delta R_{IB}$	$-85.3+TT+\Delta R_{IB}$	$-82.3+TT+\Delta R_{IB}$	$-79.3+TT+\Delta R_{IB}$

Table 7.3A.2.1.5-6a: Test Tolerance per component carrier (Reference sensitivity for power class 3)

Test Metric	$f \leq 40.8$ GHz
IFF (Max device size $\leq 30$ cm)	3.37 dB

Table 7.3A.2.1.5-7: Reference sensitivity per component carrier for power class 4

Operating band	REFSENS (dBm) / Channel bandwidth			
	50 MHz	100 MHz	200 MHz	400 MHz
n257	$-97+TT+\Delta R_{IB}$	$-94+TT+\Delta R_{IB}$	$-91+TT+\Delta R_{IB}$	$-88+TT+\Delta R_{IB}$
n258	$-97+TT+\Delta R_{IB}$	$-94+TT+\Delta R_{IB}$	$-91+TT+\Delta R_{IB}$	$-88+TT+\Delta R_{IB}$

n260	-95+TT+ $\Delta R_{IB}$	-92+TT+ $\Delta R_{IB}$	-89+TT+ $\Delta R_{IB}$	-86+TT+ $\Delta R_{IB}$
n261	-97+TT+ $\Delta R_{IB}$	-94+TT+ $\Delta R_{IB}$	-91+TT+ $\Delta R_{IB}$	-88+TT+ $\Delta R_{IB}$

### 7.3A.2.2 Reference sensitivity power level for CA (3DL CA)

Editor's note: The following aspects are either missing or not yet determined:

- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 400MHz and for intra-band non-contiguous CA are TBD.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.
- In case of frequency separation larger than 800 MHz and in case the device manufacturer does not explicitly declare that the beam peak for a reference (frequency band, CBW) or (frequency band combination, CA BW class) is applicable for a group of other intra-band contiguous combinations and CA BW classes, according to Table A.4.3.9-6 in 38.508-2, following aspect of beam peak search procedures for CA is FFS: RB allocation, power level, channel bandwidth configuration, per CC approach or all CC combined approach, etc
- Testing of extreme conditions for FR2 is FFS.

#### 7.3A.2.2.1 Test purpose

Same test purpose as in clause 7.3A.2.1.1.

#### 7.3A.2.2.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 3DL CA.

#### 7.3A.2.2.3 Minimum conformance requirements

Same minimum conformance requirements as in clause 7.3A.2.0.

#### 7.3A.2.2.4 Test description

Same test description as in clause 7.3A.2.1.4.

#### 7.3A.2.2.5 Test requirement

For each component carrier, the test requirement is the same as in clause 7.3A.2.1.5.

### 7.3A.2.3 Reference sensitivity power level for CA (4DL CA)

Editor's note: The following aspects are either missing or not yet determined:

- Measurement Uncertainties and Test Tolerances for intra-band contiguous CA supporting aggregated BW > 400MHz and for intra-band non-contiguous CA are TBD.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2 and 4.
- In case of frequency separation larger than 800 MHz and in case the device manufacturer does not explicitly declare that the beam peak for a reference (frequency band, CBW) or (frequency band combination, CA BW class) is applicable for a group of other intra-band contiguous combinations and CA BW classes, according to Table A.4.3.9-6 in 38.508-2, following aspect of beam peak search procedures for CA is FFS: RB allocation, power level, channel bandwidth configuration, per CC approach or all CC combined approach, etc
- Testing of extreme conditions for FR2 is FFS.

#### 7.3A.2.3.1 Test purpose

Same test purpose as in clause 7.3A.2.1.1.

#### 7.3A.2.3.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 4DL CA.

#### 7.3A.2.3.3 Minimum conformance requirements

Same minimum conformance requirements as in clause 7.3A.2.0.

#### 7.3A.2.3.4 Test description

Same test description as in clause 7.3A.2.1.4.

#### 7.3A.2.3.5 Test requirement

For each component carrier, the test requirement is the same as in clause 7.3A.2.1.5.

### 7.3A.2.4 Reference sensitivity power level for CA (5DL CA)

**Editor's note:** This clause is incomplete. The following aspects are either missing or not yet determined:

- Measurement Uncertainties and Test Tolerances are FFS.
- In case of frequency separation larger than 800 MHz and in case the device manufacturer does not explicitly declare that the beam peak for a reference (frequency band, CBW) or (frequency band combination, CA BW class) is applicable for a group of other intra-band contiguous combinations and CA BW classes, according to Table A.4.3.9-6 in 38.508-2, following aspect of beam peak search procedures for CA is FFS: RB allocation, power level, channel bandwidth configuration, per CC approach or all CC combined approach, etc
- Testing of extreme conditions for FR2 is FFS.

#### 7.3A.2.4.1 Test purpose

Same test purpose as in clause 7.3A.2.1.1.

#### 7.3A.2.4.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 5DL CA.

#### 7.3A.2.4.3 Minimum conformance requirements

Same minimum conformance requirements as in clause 7.3A.2.0.

#### 7.3A.2.4.4 Test description

Same test description as in clause 7.3A.2.1.4.

#### 7.3A.2.4.5 Test requirement

For each component carrier, the test requirement is the same as in clause 7.3A.2.1.5.

### 7.3A.2.5 Reference sensitivity power level for CA (6DL CA)

**Editor's note:** This clause is incomplete. The following aspects are either missing or not yet determined:

- Measurement Uncertainties and Test Tolerances are FFS.
- In case of frequency separation larger than 800 MHz and in case the device manufacturer does not explicitly declare that the beam peak for a reference (frequency band, CBW) or (frequency band combination, CA BW class) is applicable for a group of other intra-band contiguous combinations and CA BW classes, according to Table A.4.3.9-6 in 38.508-2, following aspect of beam peak search procedures for CA is FFS: RB allocation, power level, channel bandwidth configuration, per CC approach or all CC combined approach, etc

- Testing of extreme conditions for FR2 is FFS.

#### 7.3A.2.5.1 Test purpose

Same test purpose as in clause 7.3A.2.1.1.

#### 7.3A.2.5.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 6DL CA.

#### 7.3A.2.5.3 Minimum conformance requirements

Same minimum conformance requirements as in clause 7.3A.2.0.

#### 7.3A.2.5.4 Test description

Same test description as in clause 7.3A.2.1.4.

#### 7.3A.2.5.5 Test requirement

For each component carrier, the test requirement is the same as in clause 7.3A.2.1.5.

### 7.3A.2.6 Reference sensitivity power level for CA (7DL CA)

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- Measurement Uncertainties and Test Tolerances are FFS.
- In case of frequency separation larger than 800 MHz and in case the device manufacturer does not explicitly declare that the beam peak for a reference (frequency band, CBW) or (frequency band combination, CA BW class) is applicable for a group of other intra-band contiguous combinations and CA BW classes, according to Table A.4.3.9-6 in 38.508-2, following aspect of beam peak search procedures for CA is FFS: RB allocation, power level, channel bandwidth configuration, per CC approach or all CC combined approach, etc.
- Testing of extreme conditions for FR2 is FFS.

#### 7.3A.2.6.1 Test purpose

Same test purpose as in clause 7.3A.2.1.1.

#### 7.3A.2.6.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 7DL CA.

#### 7.3A.2.6.3 Minimum conformance requirements

Same minimum conformance requirements as in clause 7.3A.2.0.

#### 7.3A.2.6.4 Test description

Same test description as in clause 7.3A.2.1.4.

#### 7.3A.2.6.5 Test requirement

For each component carrier, the test requirement is the same as in clause 7.3A.2.1.5.

### 7.3A.2.7 Reference sensitivity power level for CA (8DL CA)

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- Measurement Uncertainties and Test Tolerances are FFS.

- In case of frequency separation larger than 800 MHz and in case the device manufacturer does not explicitly declare that the beam peak for a reference (frequency band, CBW) or (frequency band combination, CA BW class) is applicable for a group of other intra-band contiguous combinations and CA BW classes, according to Table A.4.3.9-6 in 38.508-2, following aspect of beam peak search procedures for CA is FFS: RB allocation, power level, channel bandwidth configuration, per CC approach or all CC combined approach, etc
- Testing of extreme conditions for FR2 is FFS.

#### 7.3A.2.7.1 Test purpose

Same test purpose as in clause 7.3A.2.1.1.

#### 7.3A.2.7.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 3DL CA.

#### 7.3A.2.7.3 Minimum conformance requirements

Same minimum conformance requirements as in clause 7.3A.2.0.

#### 7.3A.2.7.4 Test description

Same test description as in clause 7.3A.2.1.4.

#### 7.3A.2.7.5 Test requirement

For each component carrier, the test requirement is the same as in clause 7.3A.2.1.5.

### 7.3A.3 EIS spherical coverage for DL CA

#### 7.3A.3.0 Minimum Conformance Requirements

##### 7.3A.3.0.1 Void

##### 7.3A.3.0.2 Void

#### 7.3A.3.0.3 EIS spherical coverage for inter-band CA

The inter-band CA requirement applies per operating band, for all active component carriers with UL assigned to one band and one DL component carrier per band. The requirement on each component carrier shall be met when the power in the component carrier in the other band is set to its EIS spherical coverage requirement for inter-band CA specified in this sub-clause.

The inter-band CA spherical coverage requirement for each power class will be satisfied if the intersection set of spherical coverage areas exceeds the common coverage requirement. Intersection set of spherical coverage areas is defined as a fraction of area of full sphere measured around the UE where both bands meet their defined individual EIS spherical coverage requirements for inter-band CA operation. The common coverage requirement is determined as <100-percentile rank> %, where 'percentile rank' is the percentile value in the specification of spherical coverage for that power class from clause 7.3.4. The requirement is verified with the test metric of EIS (Link=Beam peak search grids, Meas=Link angle).

The reference measurement channels and throughput criterion shall be as specified in clause 7.3A.2.0.3. The requirement shall be met for an uplink transmission using QPSK DFT-s-OFDM waveforms and for uplink transmission bandwidth less than or equal to that specified in clause 7.3.2.

Unless otherwise specified, the minimum requirements for reference sensitivity shall be verified with the network signalling value NS<sub>200</sub> (Table 6.2.3.3.1-1) configured.

The required spherical coverage EIS for each band in inter-band CA operation is given in clause 7.3.4 and modified by  $\Delta R_{IB,S,n}$ . The value of  $\Delta R_{IB,S,n}$  is defined in Table 7.3A.3.0.3-1.

**Table 7.3A.3.0.3-1:  $\Delta R_{IB,S,n}$  EIS spherical coverage requirement relaxation for inter-band CA for power class 3**

NR CA band combination	NR band	$\Delta R_{IB,S,n}$ (dB)
CA_n260-n261	n260	3.5
	n261	3.5

### 7.3A.3.1 EIS Spherical Coverage for Inter-band CA (2DL CA)

**Editor's Note:** This clause is incomplete. The following aspects are either missing or not yet determined:

- Measurement Uncertainties and Test Tolerances are FFS
- Test Config is FFS.
- In case of frequency separation larger than 800 MHz and in case the device manufacturer does not explicitly declare that the beam peak for a reference (frequency band, CBW) or (frequency band combination, CA BW class) is applicable for a group of other intra-band contiguous combinations and CA BW classes, according to Table A.4.3.9-6 in 38.508-2, following aspect of beam peak search procedures for CA is FFS: RB allocation, power level, channel bandwidth configuration, per CC approach or all CC combined approach, etc

#### 7.3A.3.1.1 Test purpose

Same test purpose as in 7.3.4.1

#### 7.3A.3.1.2 Test applicability

This test case applies to all types of NR UE release 15 and forward that supports FR2 2DL inter-band CA.

#### 7.3A.3.1.3 Minimum conformance requirements

Same minimum conformance requirements as in clause 7.3A.3.0.

The normative reference for this requirement is TS 38.101-2 [3] clause 7.3A.3.

#### 7.3A.3.1.4 Test description

##### 7.3A.3.1.4.1 Initial conditions

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, test channel bandwidths and sub-carrier spacing based on NR CA configurations specified in clause 5.5A. All of these configurations shall be tested with applicable test parameters for each combination of channel bandwidth and subcarrier spacing are shown in Table [TBD], Table [TBD] and Table [TBD]. The details of the uplink and downlink reference measurement channels (RMCs) are specified in Annexes A.2 and A.3. The details of the OCNG patterns used are specified in Annex A.5. Configurations of PDSCH and PDCCCH before measurement are specified in Annex C.2.

**Table 7.3A.3.1.4.1-1: Test Configuration Table**

FFS

##### 7.3A.3.1.4.2 Test procedure

1. Configure SCC according to Annex C.0, C.1, C.2 for all downlink physical channels.
2. The SS shall configure SCC as per TS 38.508-1 [10] clause 5.5.1. Message contents are defined in clause 7.3A.3.1.4.3.

3. SS activates SCC by sending the activation MAC CE (Refer TS 38.321[28], clauses 5.9, 6.1.3.10). Wait for at least 2 seconds (Refer TS 38.133[25], clause 9.2).
4. SS transmits PDSCH via PDCCH DCI format 1\_1 for C\_RNTI to transmit the DL RMC according to Table 7.3A.3.1.4.1-1. The SS sends downlink MAC padding bits on the DL RMC.
5. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 7.3A.3.1.4.1-1. Since the UE has no payload data to send, the UE transmits uplink MAC padding bits on the UL RMC.
3. Send continuously uplink power control "up" commands in every uplink scheduling information to the UE; allow at least 200msec for the UE to reach P<sub>UMAX</sub>.
4. Set the UE in the Rx beam peak direction found with a 3D EIS scan as performed in Annex K.1.2. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Rx beam selection to complete.
5. For each component carrier, measure UE EIS value for each grid point according to EIS spherical coverage procedure defined in Annex K.1.6.0, and obtain a Complimentary Cumulative Distribution Function (CCDF) of all EIS dBm values. Alternatively, UE EIS measurement for each grid point could be done according to Rx Fast spherical coverage procedure defined in Annex K.1.6.1. After a rotation, allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for UE to find the best beam to use. EIS is calculated considering both polarizations, theta and phi.
6. Identify the EIS dBm value corresponding to %-tile (UE power class dependent) value in the applicable test requirement tables in section 7.3A.3.1.5.
7. Compare the EIS dBm value identified in step 6, to the limit value in the applicable test requirement tables in section 7.3A.3.1.5. If the EIS dBm value is lower or equal to the limit value, pass the UE. Otherwise fail the UE.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.2.

7.3A.3.1.4.3 Message contents

Same as 7.3.4.4.3

7.3A.3.1.5 Test requirement

The reference measurement channels and throughput criterion shall be as specified in section 7.3.2.5.

**Table 7.3A.3.1.5-1:  $\Delta R_{IB,S,n}$  EIS spherical coverage requirement relaxation per component carrier for inter-band CA for power class 3**

NR CA band combination	NR band	$\Delta R_{IB,S,n}$ (dB)
CA_n260-n261	n260	3.5
	n261	3.5

**Table 7.3A.3.1.5-2: EIS spherical coverage per component carrier for power class 3 for single band UE or multi-band UE declaring MB<sub>s</sub> = 0 in all FR2 bands**

Operating band	EIS at 50 <sup>th</sup> ile CCDF (dBm) / Channel bandwidth			
	50 MHz	100 MHz	200 MHz	400 MHz
n257	-77.4 +TT+ $\Delta R_{IB,S,n}$	-74.4 +TT+ $\Delta R_{IB,S,n}$	-71.4 +TT+ $\Delta R_{IB,S,n}$	-68.4 +TT+ $\Delta R_{IB,S,n}$
n259	-71.9 +TT+ $\Delta R_{IB,S,n}$	-68.9 +TT+ $\Delta R_{IB,S,n}$	-65.9 +TT+ $\Delta R_{IB,S,n}$	-62.9 +TT+ $\Delta R_{IB,S,n}$
n258	-77.4 +TT+ $\Delta R_{IB,S,n}$	-74.4 +TT+ $\Delta R_{IB,S,n}$	-71.4 +TT+ $\Delta R_{IB,S,n}$	-68.4 +TT+ $\Delta R_{IB,S,n}$
n260	-73.1 +TT+ $\Delta R_{IB,S,n}$	-70.1 +TT+ $\Delta R_{IB,S,n}$	-67.1 +TT+ $\Delta R_{IB,S,n}$	-64.1 +TT+ $\Delta R_{IB,S,n}$
n261	-77.4 +TT+ $\Delta R_{IB,S,n}$	-74.4 +TT+ $\Delta R_{IB,S,n}$	-71.4 +TT+ $\Delta R_{IB,S,n}$	-68.4 +TT+ $\Delta R_{IB,S,n}$

NOTE 1: The transmitter shall be set to P<sub>UMAX</sub> as defined in subclause 6.2.4.  
 NOTE 2: The EIS spherical coverage requirements are verified only under normal thermal conditions as defined in TS 38.508-1 [10] subclause 4.1.1.

**Table 7.3A.3.1.5-2a: EIS spherical coverage per component carrier for power class 3 for multi-band UE declaring  $MB_s > 0$  in any FR2 band (Rel-15)**

Operating band	EIS at 50 <sup>th</sup> ile CCDF (dBm) / Channel bandwidth (NOTE 3)			
	50 MHz	100 MHz	200 MHz	400 MHz
n257	-77.4 +TT+MB <sub>s</sub> + $\Delta R_{IB,S,n}$	-74.4 +TT+MB <sub>s</sub> + $\Delta R_{IB,S,n}$	-71.4 +TT+MB <sub>s</sub> + $\Delta R_{IB,S,n}$	-68.4 +TT+MB <sub>s</sub> + $\Delta R_{IB,S,n}$
n258	-77.4 +TT+MB <sub>s</sub> + $\Delta R_{IB,S,n}$	-74.4 +TT+MB <sub>s</sub> + $\Delta R_{IB,S,n}$	-71.4 +TT+MB <sub>s</sub> + $\Delta R_{IB,S,n}$	-68.4 +TT+MB <sub>s</sub> + $\Delta R_{IB,S,n}$
n260	-73.1 +TT+MB <sub>s</sub> + $\Delta R_{IB,S,n}$	-70.1 +TT+MB <sub>s</sub> + $\Delta R_{IB,S,n}$	-67.1 +TT+MB <sub>s</sub> + $\Delta R_{IB,S,n}$	-64.1 +TT+MB <sub>s</sub> + $\Delta R_{IB,S,n}$
n261	-77.4 +TT+MB <sub>s</sub> + $\Delta R_{IB,S,n}$	-74.4 +TT+MB <sub>s</sub> + $\Delta R_{IB,S,n}$	-71.4 +TT+MB <sub>s</sub> + $\Delta R_{IB,S,n}$	-68.4 +TT+MB <sub>s</sub> + $\Delta R_{IB,S,n}$

NOTE 1: The transmitter shall be set to P<sub>UMAX</sub> as defined in subclause 6.2.4.  
NOTE 2: The EIS spherical coverage requirements are verified only under normal thermal conditions as defined in TS 38.508-1 [10] subclause 4.1.1.  
NOTE 3: Refer Table 7.3A.3.1.5-2b for details for MB<sub>s</sub> allowance corresponding to supported FR2 band set combination  
NOTE 4: For a Rel-15 UE supporting FR2 bands set not defined in Table 7.3.2.3.3-1a, Table 7.3A.3.1.5-2c applies.

**Table 7.3A.3.1.5-2b: EIS spherical coverage multiband relaxation factors per component carrier for power class 3 (Rel-15)**

ID	Supported FR2 bands set	Maximum sum of MB <sub>s</sub> , $\sum MB_s$ (dB) (Note 3)	Comments
1	n257, n258	1.25	Maximum 0.75 dB relaxation allowed for each band
2	n257, n260	0.75	Maximum 0.4 dB relaxation allowed for n260 and 0.75 dB relaxation allowed for all other bands
3	n258, n260	0.75	Maximum 0.4 dB relaxation allowed for n260 and 0.75 dB relaxation allowed for all other bands
4	n258, n261	1.25	Maximum 0.75 dB relaxation allowed for each band
5	n260, n261	0.75	No relaxation allowed for n260 and 0.75 dB relaxation allowed for all other bands
6	n257, n258, n260	1.75	Maximum 0.4 dB relaxation allowed for n260 and 0.75 dB relaxation allowed for all other bands
7	n257, n258, n261	1.75	Maximum 0.75 dB relaxation allowed for each band
8	n257, n260, n261	1.25	Maximum 0.4 dB relaxation allowed for n260 and 0.75 dB relaxation allowed for all other bands
9	n258, n260, n261	1.25	Maximum 0.4 dB relaxation allowed for n260 and 0.75 dB relaxation allowed for all other bands
10	n257, n258, n260, n261	1.75	Maximum 0.4 dB relaxation allowed for n260 and 0.75 dB relaxation allowed for all other bands

NOTE 1: MB<sub>s</sub> is the Multiband Relaxation factor declared by the UE for the tested band in Table A.4.3.9-3 of TS38.508-2 [11]. This declaration shall fulfil the requirements in Table 7.3.2.3.3-1a.  
NOTE 2: All UE supported bands needs to be tested to ensure the multiband relaxation declaration is compliant  
NOTE 3: Max allowed sum of MB<sub>s</sub> over all supported FR2 bands as defined in clause 7.3.2.3.3.

**Table 7.3A.3.1.5-2c: EIS spherical coverage per component carrier for power class 3 (Rel-16 and forward)**

Operating band	EIS at 50 <sup>th</sup> ile CCDF (dBm) / Channel bandwidth (NOTE 3)			
	50 MHz	100 MHz	200 MHz	400 MHz
n257	-77.4 +TT+ $\Delta MB_{s,n}$ + $\Delta R_{IB,S,n}$	-74.4 +TT+ $\Delta MB_{s,n}$ + $\Delta R_{IB,S,n}$	-71.4 +TT+ $\Delta MB_{s,n}$ + $\Delta R_{IB,S,n}$	-68.4 +TT+ $\Delta MB_{s,n}$ + $\Delta R_{IB,S,n}$
n258	-77.4 +TT+ $\Delta MB_{s,n}$ + $\Delta R_{IB,S,n}$	-74.4 +TT+ $\Delta MB_{s,n}$ + $\Delta R_{IB,S,n}$	-71.4 +TT+ $\Delta MB_{s,n}$ + $\Delta R_{IB,S,n}$	-68.4 +TT+ $\Delta MB_{s,n}$ + $\Delta R_{IB,S,n}$
n259	-71.9 +TT+ $\Delta MB_{s,n}$ + $\Delta R_{IB,S,n}$	-68.9 +TT+ $\Delta MB_{s,n}$ + $\Delta R_{IB,S,n}$	-65.9 +TT+ $\Delta MB_{s,n}$ + $\Delta R_{IB,S,n}$	-62.9 +TT+ $\Delta MB_{s,n}$ + $\Delta R_{IB,S,n}$
n260	-73.1 +TT+ $\Delta MB_{s,n}$ + $\Delta R_{IB,S,n}$	-70.1 +TT+ $\Delta MB_{s,n}$ + $\Delta R_{IB,S,n}$	-67.1 +TT+ $\Delta MB_{s,n}$ + $\Delta R_{IB,S,n}$	-64.1 +TT+ $\Delta MB_{s,n}$ + $\Delta R_{IB,S,n}$



	$\Delta R_{IB,S,n}$	$\Delta R_{IB,S,n}$	$\Delta R_{IB,S,n}$	$\Delta R_{IB,S,n}$
n261	$-77.4 + TT + \Delta MB_{s,n} + \Delta R_{IB,S,n}$	$-74.4 + TT + \Delta MB_{s,n} + \Delta R_{IB,S,n}$	$-71.4 + TT + \Delta MB_{s,n} + \Delta R_{IB,S,n}$	$-68.4 + TT + \Delta MB_{s,n} + \Delta R_{IB,S,n}$

NOTE 1: The transmitter shall be set to  $P_{UMAX}$  as defined in subclause 6.2.4.  
 NOTE 2: The EIS spherical coverage requirements are verified only under normal thermal conditions as defined in TS 38.508-1 [10] subclause 4.1.1.  
 NOTE 3: Refer Table 7.3A.3.1.5-2d for details for  $MB_s$  allowance corresponding to supported FR2 band set combination

**Table 7.3A.3.1.5-2d: EIS spherical coverage multi-band relaxation factors per component carrier for power class 3 (Rel-16 and forward)**

ID	FR2 bands/set	Comments
1	n257	
2	n258	
3	n259	
4	n260	
5	n261	
6	n257, n261	$\Delta MB_{s,n}$ relaxation is 0 dB
7	n260, n261	$\Delta MB_{s,n}$ relaxation is 0 dB

NOTE 1:  $MB_{s,n}$  is the Multiband Relaxation factor for the tested band. This shall fulfil the requirements in Table 7.3.2.3.3-1b.

**Table 7.3A.3.1.5-3: Test Tolerance per component carrier (EIS spherical coverage for power class 3)**

Test Metric	$f \leq 40.8$ GHz
IFF (Max device size $\leq 30$ cm)	FFS

7.3A.3.2 EIS Spherical Coverage for Inter-band CA (3DL CA)

7.3A.3.3 EIS Spherical Coverage for Inter-band CA (4DL CA)

7.3D Reference sensitivity for UL MIMO

The normative reference for this requirement is TS 38.101-2 [3] clause 7.3D.

No test case details are specified. Given UE’s Rx performance would not be impacted by the Tx configuration on TDD bands, the requirements in this test case can be well covered in 7.3 and don’t need to be tested again.

7.4 Maximum input level

*Editor’s note: This clause is incomplete. The following aspects are either missing or not yet determined:*

- Measurement uncertainty is FFS.
- UL power level configuration is TBD.
- Relaxation of DL power for 256 QAM is FFS

7.4.1 Test purpose

Maximum input level tests the UE’s ability to receive data with a given average throughput for a specified reference measurement channel, under conditions of high signal level, ideal propagation and no added noise.

A UE unable to meet the throughput requirement under these conditions will decrease the coverage area near to a g-NodeB.

7.4.2 Test applicability

The minimum conformance requirements in this test case are not testable due to maximum input level unachievable in IFF OTA test setup. Other test setups have not been analysed. Thus the test case will not be tested as part of UE conformance testing.

NOTE: This does not preclude the test from being used for R&D or other purposes if deemed useful to all types of NR UEs release 15 and forward.

7.4.3 Minimum conformance requirements

The maximum input level is defined as the maximum mean power, for which the throughput shall meet or exceed the minimum requirements for the specified reference measurement channel.

The maximum input level is defined as a directional requirement. The requirement is verified in beam locked mode in the direction where peak gain is achieved.

The throughput shall be  $\geq 95\%$  of the maximum throughput of the reference measurement channels as specified in Annex A (with one sided dynamic OCNG Pattern OP.1 TDD for the DL-signal as described in Annex A.5.2.1) with parameters specified in Table 7.4.3-1. The requirement is verified with the test metric of EIS (Link=RX beam peak direction, Meas=Link angle).

**Table 7.4.3-1: Maximum input level**

Rx Parameter	Units	Channel bandwidth			
		50 MHz	100 MHz	200 MHz	400 MHz
Power in transmission bandwidth configuration	dBm	-25 (NOTE 2) -27 (NOTE 3)			
NOTE 1: The transmitter shall be set to 4 dB below the $P_{UMAX,f,c}$ as defined in subclause 6.2.4, with uplink configuration specified in Table 7.3.2.3.1-2.					
NOTE 2: Reference measurement channel is specified in Annex A.3.3.2: QPSK, R=1/3 variant with one sided dynamic OCNG Pattern as described in Annex A.					
NOTE 3: Reference measurement channel is specified in Annex A.3.3.5: 256QAM, R=4/5 variant with one sided dynamic OCNG Pattern as described in Annex A.					

The normative reference for this requirement is TS 38.101-2 [3] clause 7.4.

7.4.4 Test description

7.4.4.1 Initial conditions

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, test channel bandwidths and sub-carrier spacing based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each combination of channel bandwidth and sub-carrier spacing, are shown in Table 7.4.4.1-1. The details of the uplink and downlink reference measurement channels (RMC) are specified in Annexes A.2 and A.3. The details of the OCNG patterns used are specified in Annex A.5. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 7.4.4.1-1: Test Configuration Table**

Initial Conditions				
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1			Mid range	
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1			Lowest, Mid, Highest	
Test SCS as specified in Table 5.3.5-1			120kHz	
Test Parameters for Channel Bandwidths				
Test ID	Downlink Configuration		Uplink Configuration	
	Modulation	RB allocation	Modulation	RB allocation

1	CP-OFDM QPSK	NOTE1	DFT-s-OFDM QPSK	NOTE2
2	CP-OFDM 256QAM	NOTE1	DFT-s-OFDM QPSK	NOTE2
NOTE 1: The specific configuration of downlink RB allocation is defined in Table 7.3.2.4.1-2.				
NOTE 2: The specific configuration of uplink RB allocation is defined in Table 7.3.2.4.1-3.				

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The DL and UL Reference Measurement channels are set according to Table 7.4.4.1-1.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 7.4.4.3.

#### 7.4.4.2 Test procedure

1. SS transmits PDSCH via PDCCH DCI format 1\_1 for C\_RNTI to transmit the DL RMC according to Table 7.4.4.1-1. The SS sends downlink MAC padding bits on the DL RMC.
2. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 7.4.4.1-1. Since the UL has no payload data to send, the UE transmits uplink MAC padding bits on the UL RMC.
3. Set the Downlink signal level for  $\theta$ -polarization to the value as defined in Table 7.4.5-1.
4. Set the UE in the Rx beam peak direction found with a 3D EIS scan as performed in Annex K.1.2. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE) for the UE Rx beam selection to complete.
5. Send Uplink power control commands to the UE (less or equal to 1dB step size should be used), to ensure that the UE output power is within [TBD] dB of the target power level in Table 7.4.5-1, for at least the duration of the throughput measurement.
6. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Rx Only.
7. Measure the average throughput for a duration sufficient to achieve statistical significance according to Annex H.2.
8. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.
9. Repeat steps from 3 to 8, for the downlink signal from  $\phi$ -polarization.
10. Compare the results for both the  $\theta$ -polarization and  $\phi$ -polarization against the requirement. If either result meets the requirements, pass the UE.

NOTE: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.2.

#### 7.4.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with TRANSFORM\_PRECODER\_ENABLED condition in Table 4.6.3-118 PUSCH-Config.

#### 7.4.5 Test requirement

The throughput measurement derived in test procedure shall be  $\geq 95\%$  of the maximum throughput of the reference measurement channels as specified in Annex A with parameters specified in Tables 7.4.5-1.

Table 7.4.5-1: Maximum input level

Rx Parameter	Units	Channel bandwidth			
		50 MHz	100 MHz	200 MHz	400 MHz
Power in Transmission Bandwidth Configuration	dBm	-51 (NOTE 2,3) for band n257, n258 and n261 -59 (NOTE 2,3) for band n260 -53 (NOTE 3,4) for band n257, n258 and n261 -61 (NOTE 3,4) for band n260			
NOTE 1: The transmitter shall be set to 4 dB below the $P_{UMAX,f,c}$ as defined in subclause 6.2.4, with uplink configuration specified in Table 7.3.2.3.1-2.					
NOTE 2: Reference measurement channel is specified in Annex A.3.3.2: QPSK, R=1/3 variant with one sided dynamic OCNG Pattern as described in Annex A.					
NOTE 3: The test requirements deviate from minimum requirements by 26dB relaxation for 24.25 ~ 29.5 GHz and 34 dB relaxation for 37 ~ 40 GHz.					
NOTE 4: Reference measurement channel is specified in Annex A.3.3.5: 256QAM, R=4/5 variant with one sided dynamic OCNG Pattern as described in Annex A.					

## 7.4A Maximum input level for CA

### 7.4A.0 Minimum Conformance Requirements

#### 7.4A.0.1 Maximum input level for Intra-band contiguous CA

For intra-band contiguous carrier aggregation the input level is defined as the cumulative received power, summed over the transmission bandwidth configurations of each active DL CC. All DL CCs shall be active throughout the test. The input power shall be distributed among the active DL CCs so their PSDs are aligned with each other. At the maximum input level, the specified relative throughput shall meet or exceed the minimum requirements for the specified reference measurement channel over each component carrier. The minimum requirement is specified in Table 7.4A.0.1-1.

The maximum input level is defined as a directional requirement. The requirement is verified in beam locked mode in the direction where peak gain is achieved. The requirement is verified with the test metric of EIS (Link=RX beam peak direction, Meas=Link angle).

Table 7.4A.0.1-1: Maximum input level for Intra-band contiguous CA

Rx Parameter	Units	Level
Power summed over transmission bandwidth configurations of all active DL CCs	dBm	-25 (NOTE 2) -27 (NOTE 3)
NOTE 1: The transmitter shall be set to 4 dB below the $P_{UMAX,f,c}$ as defined in clause 6.2.4, with uplink configuration specified in Table 7.3.2.3.1-2.		
NOTE 2: Reference measurement channel in each CC is specified in Annex A.3.3.2: QPSK, R=1/3 variant with one sided dynamic OCNG Pattern as described in Annex A.		
NOTE 3: Reference measurement channel is specified in Annex A.3.3.5: 256QAM, R=4/5 variant with one sided dynamic OCNG Pattern as described in Annex A.		

#### 7.4A.0.2 Maximum input level for Intra-band non-contiguous CA

For intra-band non-contiguous carrier aggregation the requirement of clause 7.4A.0.1 applies.

#### 7.4A.0.3 Maximum input level for inter-band CA

For inter-band carrier aggregation with one component carrier per operating band and the uplink assigned to one NR band, the maximum input level is defined with the uplink active on the band other than the band whose downlink is being tested. The UE shall meet the requirements specified in clause 7.4 for each component carrier while all downlink carriers are active.

## 7.4A.1 Maximum input level for CA (2DL CA)

Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:

- Measurement uncertainty and test requirement are FFS.
- UL power level configuration is TBD.
- Relaxation of DL power for 256 QAM is FFS.
- Test for DL intra-band non-contiguous configurations with UL intra-band contiguous configuration is FFS.
- Test Config and Test requirements for Inter-band CA tests is FFS

### 7.4A.1.1 Test purpose

Same test purpose as in clause 7.4.1.

### 7.4A.1.2 Test applicability

This test case applies to all types of NR UEs release 15 and forward that support FR2 2DL CA.

The minimum conformance requirements in this test case are not testable due to maximum input level unachievable in IFF OTA test setup. Other test setups have not been analysed. Thus the test case will not be tested as part of UE conformance testing.

NOTE: This does not preclude the test from being used for R&D or other purposes if deemed useful to all types of NR UEs release 15 and forward that support FR2 2DL CA.

### 7.4A.1.3 Minimum conformance requirements

Same minimum conformance requirements as in clause 7.4A.0.

### 7.4A.1.4 Test description

#### 7.4A.1.4.1 Initial conditions

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, and channel bandwidths and sub-carrier spacing based on NR CA configurations specified in clause 5.5A. All of these configurations shall be tested with applicable test parameters for each combination of channel bandwidth and sub-carrier spacing, are shown in Table 7.4A.1.4.1-1. The details of the uplink and downlink reference measurement channels (RMC) are specified in Annexes A.2 and A.3. The details of the OCNG patterns used are specified in Annex A.5. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 7.4A.1.4.1-1: Test Configuration Table**

Initial Conditions				
Test Environment as specified in TS 38.508-1 [10] subclause 4.1			Normal	
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 and 4.3.1.2.4 for different CA bandwidth classes			For intra-band contiguous CA: Mid range For intra-band non-contiguous CA: FFS. For inter-band CA: FFS	
Test CA Bandwidth combination as specified in TS 38.508-1 [10] subclause 4.3.1.2.3 and 4.3.1.2.4 for the CA Configuration across bandwidth combination sets supported by the UE			Maximum aggregated BW (contiguous CA) or Maximum cumulative aggregated BW (non-contiguous CA)	
Test SCS as specified in Table 5.3.5-1			120kHz	
Test Parameters				
Test ID	Downlink Configuration		Uplink Configuration	
	Modulation	RB allocation	Modulation	RB allocation
1	CP-OFDM QPSK	Full RB	DFT-s-OFDM QPSK	REFSENS (NOTE 2,

		(NOTE 1)		NOTE 3)
2	CP-OFDM 256QAM	Full RB (NOTE 1)	DFT-s-OFDM QPSK	REFSENS (NOTE 2, NOTE 3)
NOTE 1: Full RB allocation shall be used per each SCS and component carrier as specified in Table 7.3A.2.1.4.1-2.				
NOTE 2: REFSENS refers to Table 7.3A.2.1.4.1-3 which defines uplink RB configuration and start RB location for each SCS, channel BW.				
NOTE 3: Use single carrier UL when testing Maximum input level for CA. The PCC is located on the CC with the lowest carrier frequency.				

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.1 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The DL and UL Reference Measurement channels are set according to Table 7.4A.1.4.1-1.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in State RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 7.4A.1.4.3.

#### 7.4A.1.4.2 Test Procedure

1. Configure SCC according to Annex C.0, C.1, C.2 for all downlink physical channels.
2. The SS shall configure SCC as per TS 38.508-1 [10] clause 5.5.1. Message contents are defined in clause 7.4A.1.4.3.
3. SS activates SCC by sending the activation MAC CE (Refer TS 38.321[28], clauses 5.9, 6.1.3.10). Wait for at least 2 seconds (Refer TS 38.133[25], clause 9.2).
4. SS transmits PDSCH via PDCCH DCI format 1\_1 for C\_RNTI to transmit the DL RMC according to Table 7.4A.1.4.1-1. The SS sends downlink MAC padding bits on the DL RMC.
5. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 7.4A.1.4.1-1. Since the UE has no payload data to send, the UE transmits uplink MAC padding bits on the UL RMC.
6. Set the Downlink signal level for  $\theta$ -polarization to the value as defined in Table 7.4A.1.5-1.
7. Set the UE in the Rx beam peak direction found with a 3D EIS scan as performed in Annex K.1.2. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE) for the UE Rx beam selection to complete.
8. Send Uplink power control commands to the UE (less or equal to 1dB step size should be used), to ensure that the UE output power is within [TBD] dB of the target power level in Table 7.4A.1.5-1, for at least the duration of the throughput measurement.
9. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Rx Only.
10. For each component carrier, ensure the average throughput for a duration sufficient to achieve statistical significance according to Annex H.2.
11. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.
12. Repeat steps from 3 to 8, for the downlink signal from  $\phi$ -polarization.
13. Compare the results for both the  $\theta$ -polarization and  $\phi$ -polarization against the requirement. If either result meets the requirements, pass the UE.

NOTE: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.2.

#### 7.4A.1.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with TRANSFORM\_PRECODER\_ENABLED condition in Table 4.6.3-118 PUSCH-Config.

#### 7.4A.1.5 Test requirement

The throughput measurement derived in test procedure shall be  $\geq 95\%$  of the maximum throughput of the reference measurement channels as specified in Annex A with parameters specified in Tables 7.4A.1.5-1.

**Table 7.4A.1.5-1: Maximum input level for Intra-band contiguous and Intra-band non-contiguous CA**

Rx Parameter	Units	Level
Power summed over transmission bandwidth configurations of all active DL CCs	dBm	[-51 (NOTE 2,3) for band n257, n258 and n261 -59 (NOTE 2,3) for band n260] [-53 (NOTE 3,4) for band n257, n258 and n261 -61 (NOTE 3,4) for band n260]
NOTE 1: The transmitter shall be set to 4 dB below the $P_{UMAX,f,c}$ as defined in subclause 6.2.4, with uplink configuration specified in Table 7.3.2.3.1-2.		
NOTE 2: Reference measurement channel in each CC is specified in Annex A.3.3.2: QPSK, R=1/3 variant with one sided dynamic OCNG Pattern as described in Annex A.		
[NOTE 3: The test requirements deviate from minimum requirements by 26dB relaxation for 24.25 ~ 29.5 GHz and 34 dB relaxation for 37 ~ 40 GHz.]		
NOTE 4: Reference measurement channel is specified in Annex A.3.3.5: 256QAM, R=4/5 variant with one sided dynamic OCNG Pattern as described in Annex A.		

### 7.4A.2 Maximum input level for CA (3DL CA)

Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:

- Measurement uncertainty and test requirement are FFS.
- UL power level configuration is TBD.

#### 7.4A.2.1 Test purpose

Same test purpose as in clause 7.4A.1.1.

#### 7.4A.2.2 Test applicability

This test case applies to all types of NR UEs release 15 and forward that support FR2 3DL CA.

The minimum conformance requirements in this test case are not testable due to maximum input level unachievable in IFF OTA test setup. Other test setups have not been analysed. Thus the test case will not be tested as part of UE conformance testing.

NOTE: This does not preclude the test from being used for R&D or other purposes if deemed useful to all types of NR UEs release 15 and forward that support FR2 3DL CA.

#### 7.4A.2.3 Minimum conformance requirements

Same minimum conformance requirements as in clause 7.4A.0.

#### 7.4A.2.4 Test description

Same test description as in clause 7.4A.1.4.

#### 7.4A.2.5 Test requirement

The test requirement is the same as in clause 7.4A.1.5.

### 7.4A.3 Maximum input level for CA (4DL CA)

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- Measurement uncertainty and test requirement are FFS.
- UL power level configuration is TBD.

#### 7.4A.3.1 Test purpose

Same test purpose as in clause 7.4A.1.1.

#### 7.4A.3.2 Test applicability

This test case applies to all types of NR UEs release 15 and forward that support FR2 4DL CA.

The minimum conformance requirements in this test case are not testable due to maximum input level unachievable in IFF OTA test setup. Other test setups have not been analysed. Thus the test case will not be tested as part of UE conformance testing.

NOTE: This does not preclude the test from being used for R&D or other purposes if deemed useful to all types of NR UEs release 15 and forward that support FR2 4DL CA.

#### 7.4A.3.3 Minimum conformance requirements

Same minimum conformance requirements as in clause 7.4A.0.

#### 7.4A.3.4 Test description

Same test description as in clause 7.4A.1.4.

#### 7.4A.3.5 Test requirement

The test requirement is the same as in clause 7.4A.1.5.

### 7.4A.4 Maximum input level for CA (5DL CA)

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- Measurement uncertainty and test requirement are FFS.
- UL power level configuration is TBD.

#### 7.4A.4.1 Test purpose

Same test purpose as in clause 7.4A.1.1.

#### 7.4A.4.2 Test applicability

This test case applies to all types of NR UEs release 15 and forward that support FR2 5DL CA.

The minimum conformance requirements in this test case are not testable due to maximum input level unachievable in IFF OTA test setup. Other test setups have not been analysed. Thus the test case will not be tested as part of UE conformance testing.

NOTE: This does not preclude the test from being used for R&D or other purposes if deemed useful to all types of NR UEs release 15 and forward that support FR2 5DL CA.



#### 7.4A.4.3 Minimum conformance requirements

Same minimum conformance requirements as in clause 7.4A.0.

#### 7.4A.4.4 Test description

Same test description as in clause 7.4A.1.4.

#### 7.4A.4.5 Test requirement

The test requirement is the same as in clause 7.4A.1.5.

### 7.4A.5 Maximum input level for CA (6DL CA)

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- Measurement uncertainty and test requirement are FFS.
- UL power level configuration is TBD.

#### 7.4A.5.1 Test purpose

Same test purpose as in clause 7.4A.1.1.

#### 7.4A.5.2 Test applicability

This test case applies to all types of NR UEs release 15 and forward that support FR2 6DL CA.

The minimum conformance requirements in this test case are not testable due to maximum input level unachievable in IFF OTA test setup. Other test setups have not been analysed. Thus the test case will not be tested as part of UE conformance testing.

NOTE: This does not preclude the test from being used for R&D or other purposes if deemed useful to all types of NR UEs release 15 and forward that support FR2 6DL CA.

#### 7.4A.5.3 Minimum conformance requirements

Same minimum conformance requirements as in clause 7.4A.0.

#### 7.4A.5.4 Test description

Same test description as in clause 7.4A.1.4.

#### 7.4A.5.5 Test requirement

The test requirement is the same as in clause 7.4A.1.5.

### 7.4A.6 Maximum input level for CA (7DL CA)

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- Measurement uncertainty and test requirement are FFS.
- UL power level configuration is TBD.

#### 7.4A.6.1 Test purpose

Same test purpose as in clause 7.4A.1.1.

#### 7.4A.6.2 Test applicability

This test case applies to all types of NR UEs release 15 and forward that support FR2 7DL CA.

The minimum conformance requirements in this test case are not testable due to maximum input level unachievable in IFF OTA test setup. Other test setups have not been analysed. Thus the test case will not be tested as part of UE conformance testing.

NOTE: This does not preclude the test from being used for R&D or other purposes if deemed useful to all types of NR UEs release 15 and forward that support FR2 7DL CA.

#### 7.4A.6.3 Minimum conformance requirements

Same minimum conformance requirements as in clause 7.4A.0.

#### 7.4A.6.4 Test description

Same test description as in clause 7.4A.1.4.

#### 7.4A.6.5 Test requirement

The test requirement is the same as in clause 7.4A.1.5.

### 7.4A.7 Maximum input level for CA (8DL CA)

**Editor's note: This clause is incomplete. The following aspects are either missing or not yet determined:**

- Measurement uncertainty and test requirement are FFS.
- UL power level configuration is TBD.

#### 7.4A.7.1 Test purpose

Same test purpose as in clause 7.4A.1.1.

#### 7.4A.7.2 Test applicability

This test case applies to all types of NR UEs release 15 and forward that support FR2 8DL CA.

The minimum conformance requirements in this test case are not testable due to maximum input level unachievable in IFF OTA test setup. Other test setups have not been analysed. Thus the test case will not be tested as part of UE conformance testing.

NOTE: This does not preclude the test from being used for R&D or other purposes if deemed useful to all types of NR UEs release 15 and forward that support FR2 8DL CA.

#### 7.4A.7.3 Minimum conformance requirements

Same minimum conformance requirements as in clause 7.4A.0.

#### 7.4A.7.4 Test description

Same test description as in clause 7.4A.1.4.

#### 7.4A.7.5 Test requirement

The test requirement is the same as in clause 7.4A.1.5.

### 7.4D Maximum input level for UL MIMO

The normative reference for this requirement is TS 38.101-2 [3] clause 7.4D.

No test case details are specified. Given UE's Rx performance would not be impacted by the Tx configuration on TDD bands, the requirements in this test case can be well covered in 7.4 and don't need to be tested again.

## 7.5 Adjacent channel selectivity

**Editor's note: The following aspects are either missing or not yet determined:**

- **Measurement Uncertainty is FFS for power class 1,2 and 4.**
- **The minimum conformance requirements for Case 2 in this test case are not testable due to maximum input level unachievable in IFF OTA test setup. Other test setups have not been analysed.**

### 7.5.1 Test purpose

Adjacent channel selectivity tests the UE's ability to receive data with a given average throughput for a specified reference measurement channel, in the presence of an adjacent channel signal at a given frequency offset from the centre frequency of the assigned channel, under conditions of ideal propagation and no added noise.

### 7.5.2 Test applicability

This test applies to all types of NR UE release 15 and forward.

### 7.5.3 Minimum conformance requirements

Adjacent Channel Selectivity (ACS) is a measure of a receiver's ability to receive a NR signal at its assigned channel frequency in the presence of an adjacent channel signal at a given frequency offset from the centre frequency of the assigned channel. ACS is the ratio of the receive filter attenuation on the assigned channel frequency to the receive filter attenuation on the adjacent channel(s).

The requirement applies at the Radiated Interface Boundary (RIB) when the AoA of the incident wave of the wanted signal and the interfering signal are both from the direction where peak gain is achieved.

The wanted and interfering signals apply to all supported polarizations, under the assumption of polarization match.

The UE shall fulfil the minimum requirement specified in Table 7.5.3-1 for all values of an adjacent channel interferer up to  $-25$  dBm. However, it is not possible to directly measure the ACS, instead the lower and upper range of test parameters are chosen in Table 7.5.3-2 and Table 7.5.3-3 where the throughput shall be  $\geq 95\%$  of the maximum throughput of the reference measurement channels as specified in Annexes A.2.3.2 and A.3.3.2, with one sided dynamic OCNG Pattern OP.1 TDD for the DL-signal as described in Annex A.5.2.1. The requirement is verified with the test metric of EIS (Link=RX beam peak direction, Meas=Link angle).

**Table 7.5.3-1: Adjacent channel selectivity**

Rx Parameter	Units	Channel bandwidth			
		50 MHz	100 MHz	200 MHz	400 MHz
ACS for band n257, n258, n261	dB	23	23	23	23
ACS for band n259, n260	dB	22	22	22	22

**Table 7.5.3-2: Test parameters for adjacent channel selectivity, Case 1**

Rx Parameter	Units	Channel bandwidth			
		50 MHz	100 MHz	200 MHz	400 MHz
Power in Transmission Bandwidth Configuration	dBm	REFSENS + 14 dB			
$P_{\text{Interferer}}$ for band n257, n258,	dBm	REFSENS + 35.5 dB	REFSENS +35.5dB	REFSENS +35.5dB	REFSENS +35.5dB

n261					
$P_{\text{Interferer}}$ for band n259, n260	dBm	REFSENS + 34.5 dB	REFSENS +34.5dB	REFSENS +34.5dB	REFSENS +34.5dB
$BW_{\text{Interferer}}$	MHz	50	100	200	400
$F_{\text{Interferer}}$ (offset)	MHz	50 / -50 NOTE 3	100 / -100 NOTE 3	200 / -200 NOTE 3	400 / -400 NOTE 3
<p>NOTE 1: The interferer consists of the Reference measurement channel specified in Annex A.3.3 with one sided dynamic OCNG Pattern as described in Annex A.5.2.1 and set-up according to Annex C.</p> <p>NOTE 2: The REFSENS power level is specified in subclause 7.3.2.3, which are applicable to different UE power classes.</p> <p>NOTE 3: The absolute value of the interferer offset <math>F_{\text{Interferer}}</math> (offset) shall be further adjusted to <math>(\text{CEIL}( F_{\text{Interferer}} /\text{SCS}) + 0.5) * \text{SCS}</math> MHz with SCS the sub-carrier spacing of the wanted signal in MHz. Wanted and interferer signal have same SCS.</p> <p>NOTE 4: The transmitter shall be set to 4 dB below the <math>P_{\text{UMAX},f,c}</math> as defined in clause 6.2.4, with uplink configuration specified in Table 7.3.2.3.1-2.</p>					

**Table 7.5.3-3: Test parameters for adjacent channel selectivity, Case 2**

Rx Parameter	Units	Channel bandwidth			
		50 MHz	100 MHz	200 MHz	400 MHz
Power in Transmission Bandwidth Configuration for band n257, n258, n261	dBm	-46.5	-46.5	-46.5	-46.5
Power in Transmission Bandwidth Configuration for band n259, n260	dBm	-45.5	-45.5	-45.5	-45.5
$P_{\text{Interferer}}$	dBm	-25			
$BW_{\text{Interferer}}$	MHz	50	100	200	400
$F_{\text{Interferer}}$ (offset)	MHz	50 / -50 NOTE 2	100 / -100 NOTE 2	200 / -200 NOTE 2	400 / -400 NOTE 2
<p>NOTE 1: The interferer consists of the Reference measurement channel specified in Annex A.3.3 with one sided dynamic OCNG Pattern TDD as described in Annex A.5.2.1 and set-up according to Annex C.</p> <p>NOTE 2: The absolute value of the interferer offset <math>F_{\text{Interferer}}</math> (offset) shall be further adjusted to <math>(\text{CEIL}( F_{\text{Interferer}} /\text{SCS}) + 0.5) * \text{SCS}</math> MHz with SCS the sub-carrier spacing of the wanted signal in MHz. Wanted and interferer signal have same SCS.</p> <p>NOTE 3: The transmitter shall be set to 4 dB below the <math>P_{\text{UMAX},f,c}</math> as defined in clause 6.2.4, with uplink configuration specified in Table 7.3.2.3.1-2.</p>					

The normative reference for this requirement is TS 38.101-2 [3] clause 7.5.

**7.5.4 Test description**

**7.5.4.1 Initial conditions**

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, and test channel bandwidths and sub-carrier spacing based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each combination of channel bandwidth and subcarrier spacing, are shown in Table 7.5.4.1-1. The details of the uplink and downlink reference measurement channels (RMCs) are specified in Annexes A.2 and A.3. The details of the OCNG patterns used are specified in Annex A.5. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

Table 7.5.4.1-1: Test Configuration

Initial Conditions				
Test Environment as specified in TS 38.508-1 [10] subclause 4.1		Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1		Mid range		
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1		50 MHz, 100 MHz		
Test SCS as specified in Table 5.3.5-1		120 kHz		
Test Parameters				
Test ID	Downlink Configuration		Uplink Configuration	
	Modulation	RB allocation	Modulation	RB allocation
1	CP-OFDM QPSK	NOTE 1	DFT-s-OFDM QPSK	NOTE 1
NOTE 1: The specific configuration of each RB allocation is defined in Table 7.3.2.4.1-1.				

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.2 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The DL and UL Reference Measurement channels are set according to Table 7.5.4.1-1.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity *NR*, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message contents are defined in clause 7.5.4.3.

#### 7.5.4.2 Test procedure

1. Set the UE in the Rx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.2. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Rx beam selection to complete.
2. SS transmits PDSCH via PDCCH DCI format 1\_1 for C\_RNTI to transmit the DL RMC according to Table 7.5.4.1-1. The SS sends downlink MAC padding bits on the DL RMC.
3. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 7.5.4.1-1. Since the UL has no payload data to send, the UE transmits uplink MAC padding bits on the UL RMC.
4. Send Uplink power control commands to the UE (less or equal to 1dB step size should be used), to ensure that the UE output power measured by the test system is within the Uplink power control window, defined as  $-(\text{MU})$  to  $-(\text{MU} + \text{Uplink power control window size})$  dB of the target power level in Table 7.5.5-2 (Case 1) or Table 7.5.5-3 (Case 2), for at least the duration of the throughput measurement, where:
  - MU is the test system uplink power measurement uncertainty and is specified in Table F.1.3-1 for the carrier frequency  $f$  and the channel bandwidth BW.
  - Uplink power control window size = 1dB (UE power step size) + 1dB (UE power step tolerance) + (Test system relative power measurement uncertainty), where, the UE power step tolerance is specified in TS 38.101-2 [3], Table 6.3.4.3-2 and is 1dB for 1dB power step size, and the Test system relative power measurement uncertainty is specified in Table F.1.3-1.
5. Perform Blocking measurement procedure as stated in Annex K.1.8 using Downlink signal level and Interferer signal level as defined in Table 7.5.5-2 (Case 1). Modulated interferer signal characteristics as defined in Annex D with frequency below the wanted signal. Measure throughput for a duration sufficient to achieve statistical significance according to Annex H.2.
6. Repeat step 5 using an interfering signal frequency above the wanted signal in Case 1.

7. Perform Blocking measurement procedure as stated in Annex K.1.8 using Downlink signal level and Interferer signal level as defined in Table 7.5.5-3 (Case 2). Modulated interferer signal characteristics as defined in Annex D with frequency below the wanted signal. Measure throughput for a duration sufficient to achieve statistical significance according to Annex H.2.
8. Repeat step 7 using an interfering signal frequency above the wanted signal in Case 2.
9. Repeat for applicable channel bandwidths and operating band combinations in both Case 1 and Case 2.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.2.

7.5.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with TRANSFORM\_PRECODER\_ENABLED condition in Table 4.6.3-118 PUSCH-Config.

7.5.5 Test requirements

The throughput measurement derived in test procedure shall be  $\geq 95\%$  of the maximum throughput of the reference measurement channels as specified in Annex A, under the conditions specified in Table 7.5.5-2 and also under the conditions specified in Table 7.5.5-3.

Table 7.5.5-1: Adjacent channel selectivity

Rx Parameter	Units	Channel bandwidth			
		50 MHz	100 MHz	200 MHz	400 MHz
ACS for band n257, n258, n261	dB	23	23	23	23
ACS for band n260	dB	22	22	22	22

Table 7.5.5-2: Test parameters for adjacent channel selectivity, Case 1

Rx Parameter	Units	Channel bandwidth			
		50 MHz	100 MHz	200 MHz	400 MHz
Power in Transmission Bandwidth Configuration for band n257, n258, n261	dBm	REFSENS + 14 dB			
Power in Transmission Bandwidth Configuration for band n260	dBm	REFSENS + 14 - 1.8 dB NOTE 4	REFSEN + 14 - 4.8 dB NOTE 4	REFSENS + 14 dB	REFSENS + 14 dB
$P_{\text{Interferer}}$ for band n257, n258, n261	dBm	REFSENS + 35.5 dB	REFSENS +35.5dB	REFSENS +35.5dB NOTE 5	REFSENS +35.5dB NOTE 5
$P_{\text{Interferer}}$ for band n260	dBm	REFSENS + 34.5 - 1.8 dB NOTE 4	REFSENS +34.5 - 4.8 dB NOTE 4	REFSENS +34.5dB NOTE 5	REFSENS +34.5dB NOTE 5
$BW_{\text{Interferer}}$	MHz	50	100	200	400
$F_{\text{Interferer}}$ (offset)	MHz	50 / -50 NOTE 3	100 / -100 NOTE 3	200 / -200 NOTE 3	400 / -400 NOTE 3

NOTE 1: The interferer consists of the Reference measurement channel specified in Annex A.3.3 with one sided dynamic OCNG Pattern as described in Annex A.5.2.1 and set-up according to Annex C.

NOTE 2: The REFSENS power level is specified in subclause 7.3.2.5.

NOTE 3: The absolute value of the interferer offset  $F_{\text{Interferer}}$  (offset) shall be further adjusted to  $(|F_{\text{Interferer}}|/SCS) + 0.5$  SCS MHz with SCS the sub-carrier spacing of the wanted signal in MHz. Wanted and interferer signal have same SCS.

NOTE 4: Core requirement cannot be tested due to testability issue and test requirement for wanted signal and interferer includes relaxation to achieve feasible interferer power level.
NOTE 5: Core requirement cannot be tested due to testability issue.
NOTE 6: The transmitter shall be set to 4 dB below the $P_{UMAX,f,c}$ as defined in clause 6.2.4, with uplink configuration specified in Table 7.3.2.3.1-2.

Table 7.5.5-3: Test parameters for adjacent channel selectivity, Case 2

Rx Parameter	Units	Channel bandwidth			
		50 MHz	100 MHz	200 MHz	400 MHz
Power in Transmission Bandwidth Configuration for band n257, n258, n261	dBm	-46.5	-46.5	-46.5	-46.5
Power in Transmission Bandwidth Configuration for band n260	dBm	-45.5	-45.5	-45.5	-45.5
$P_{Interferer}$	dBm	-25			
$BW_{Interferer}$	MHz	50	100	200	400
$F_{Interferer}$ (offset)	MHz	50 / -50 NOTE 2	100 / -100 NOTE 2	200 / -200 NOTE 2	400 / -400 NOTE 2
NOTE 1: The interferer consists of the Reference measurement channel specified in Annex A.3.3 with one sided dynamic OCNG Pattern TDD as described in Annex A.5.2.1 and set-up according to Annex C.					
NOTE 2: The absolute value of the interferer offset $F_{Interferer}$ (offset) shall be further adjusted to $(\lfloor P_{Interferer} / SCS \rfloor + 0.5) SCS$ MHz with SCS the sub-carrier spacing of the wanted signal in MHz. Wanted and interferer signal have same SCS.					
NOTE 3: The transmitter shall be set to 4 dB below the $P_{UMAX,f,c}$ as defined in clause 6.2.4, with uplink configuration specified in Table 7.3.2.3.1-2.					

## 7.5A Adjacent channel selectivity for CA

### 7.5A.0 Minimum Conformance Requirements

#### 7.5A.0.1 Adjacent channel selectivity for Intra-band contiguous CA

For intra-band contiguous carrier aggregation, the SCC(s) shall be configured at nominal channel spacing to the PCC. The input power shall be distributed among the active DL CCs so their PSDs are aligned with each other. The UE shall fulfil the minimum requirement specified in Table 7.5A.0.1-1 for an adjacent channel interferer on either side of the aggregated downlink signal at a specified frequency offset and for an interferer power up to -25 dBm.

The throughput of each carrier shall be  $\geq 95\%$  of the maximum throughput of the reference measurement channels as specified in Annexes A.2.3.2 and A.3.3.2 (with one sided dynamic OCNG Pattern OP.1 TDD for the DL-signal as described in Annex A.5.2.1). The requirement is verified with the test metric of EIS (Link=RX beam peak direction, Meas=Link angle).

Table 7.5A.0.1-1: Adjacent channel selectivity for intra-band contiguous CA

Operating band	Units	Adjacent channel selectivity / CA bandwidth class
		All CA bandwidth class
n257, n258, n261	dB	23
n259, n260	dB	22

**Table 7.5A.0.1-2: Adjacent channel selectivity test parameters for intra-band contiguous CA, Case 1**

Rx Parameter	Units	All CA bandwidth Classes
P <sub>w</sub> in Transmission Bandwidth Configuration, per CC		REFSENS + 14 dB
P <sub>Interferer</sub> for band n257, n258, n261	dBm	Aggregated power + 21.5
P <sub>Interferer</sub> for band n259, n260	dBm	Aggregated power + 20.5
BW <sub>Interferer</sub>	MHz	BW <sub>Channel_CA</sub>
F <sub>Interferer</sub> (offset)	MHz	+ BW <sub>channel CA</sub> / - BW <sub>channel CA</sub>  NOTE 3
<p>NOTE 1: The interferer consists of the Reference measurement channel specified in Annex 3.3.2 with one sided dynamic OCNG Pattern as described in Annex A and set-up according to Annex C.</p> <p>NOTE 2: The F<sub>Interferer</sub> (offset) is the frequency separation between the centre of the aggregated CA bandwidth and the centre frequency of the Interferer signal</p> <p>NOTE 3: The absolute value of the interferer offset F<sub>Interferer</sub> (offset) shall be further adjusted to (CEIL( F<sub>Interferer</sub> /SCS) + 0.5)*SCS MHz with SCS the sub-carrier spacing of the carrier closest to the interferer in MHz. The interfering signal has the same SCS as that of the closest carrier.</p> <p>NOTE 4: The transmitter shall be set to 4 dB below the P<sub>UMAX,f,c</sub> as defined in clause 6.2.4, with uplink configuration specified in Table 7.3.2.3.1-2.</p>		

**Table 7.5A.0.1-3: Adjacent channel selectivity test parameters for intra-band contiguous CA, Case 2**

Rx Parameter	Units	All CA bandwidth classes
P <sub>w</sub> in Transmission Bandwidth Configuration, aggregated power for band n257, n258, n261	dBm	- 46.5
P <sub>w</sub> in Transmission Bandwidth Configuration, aggregated power for band n259, n260	dBm	- 45.5
P <sub>Interferer</sub>	dBm	- 25
BW <sub>Interferer</sub>	MHz	BW <sub>Channel_CA</sub>
F <sub>Interferer</sub> (offset)	MHz	+ BW <sub>channel CA</sub> / - BW <sub>channel CA</sub>  NOTE 3
<p>NOTE 1: The interferer consists of the Reference measurement channel specified in Annex A.3.3.2 with one sided dynamic OCNG Pattern OP.1 TDD as described in Annex A.5.2.1 and set-up according to Annex C.</p> <p>NOTE 2: The F<sub>Interferer</sub> (offset) is the frequency separation between the centre of the aggregated CA bandwidth and the centre frequency of the Interferer signal</p> <p>NOTE 3: The absolute value of the interferer offset F<sub>Interferer</sub> (offset) shall be further adjusted to (CEIL( F<sub>Interferer</sub> /SCS) + 0.5)*SCS MHz with SCS the sub-carrier spacing of the carrier closest to the interferer in MHz. The interfering signal has the same SCS as that of the closest carrier.</p> <p>NOTE 4: The transmitter shall be set to 4 dB below the P<sub>UMAX,f,c</sub> as defined in clause 6.2.4, with uplink configuration specified in Table 7.3.2.3.1-2.</p>		

### 7.5A.0.2 Adjacent channel selectivity for Intra-band non-contiguous CA

For intra-band non-contiguous carrier aggregation with two component carriers, two different requirements apply for out-of-gap and in-gap. For out-of-gap, the UE shall meet the requirements for each component carrier as specified in clauses 7.5. For in-gap, the requirement applies if the following minimum gap condition is met:

$$\Delta f_{ACS} \geq BW_1/2 + BW_2/2 + \max(BW_1, BW_2),$$

where  $\Delta f_{ACS}$  is the frequency separation between the centre frequencies of the component carriers and  $BW_k$  are the channel bandwidths of carrier  $k$ ,  $k = 1, 2$ .



If the minimum gap condition is met, the UE shall meet the requirements specified in clauses 7.5 for each component carrier considered. The respective channel bandwidth of the component carrier under test will be used in the parameter calculations of the requirement. In case of more than two component carriers, the minimum gap condition is computed for any pair of adjacent component carriers following the same approach as the two component carriers. The in-gap requirement for the corresponding pairs shall apply if the minimum gap condition is met.

For every component carrier to which the requirements apply, the UE shall meet the requirement with one active interferer signal (in-gap or out-of-gap) while all downlink carriers are active and the input power shall be distributed among the active DL CCs so their PSDs are aligned with each other.

### 7.5A.0.3 Adjacent channel selectivity for Inter-band CA

For inter-band carrier aggregation with one component carrier per operating band and the uplink assigned to one NR band, the adjacent channel requirements are defined with the uplink active on the band other than the band whose downlink is being tested. The UE shall meet the requirements specified in clause 7.5 for each component carrier while all downlink carriers are active.

#### 7.5A.1 Adjacent channel selectivity for CA (2DL CA)

FFS

#### 7.5A.2 Adjacent channel selectivity for CA (3DL CA)

FFS

#### 7.5A.3 Adjacent channel selectivity for CA (4DL CA)

FFS

#### 7.5A.4 Adjacent channel selectivity for CA (5DL CA)

FFS

#### 7.5A.5 Adjacent channel selectivity for CA (6DL CA)

FFS

#### 7.5A.6 Adjacent channel selectivity for CA (7DL CA)

FFS

#### 7.5A.7 Adjacent channel selectivity for CA (8DL CA)

FFS

### 7.5D Adjacent channel selectivity for UL MIMO

The normative reference for this requirement is TS 38.101-2 [3] clause 7.5D.

No test case details are specified. Given UE's Rx performance would not be impacted by the Tx configuration on TDD bands, the requirements in this test case can be well covered in 7.5 and don't need to be tested again.

## 7.6 Blocking characteristics

### 7.6.1 General

The blocking characteristic is a measure of the receiver's ability to receive a wanted signal at its assigned channel frequency in the presence of an unwanted interferer on frequencies other than those of the spurious response or the adjacent channels, without this unwanted input signal causing a degradation of the performance of the receiver beyond a specified limit. The blocking performance shall apply at all frequencies except those at which a spurious response occurs.

The requirement applies at the RIB when the AoA of the incident wave of the wanted signal and the interfering signal are both from the direction where peak gain is achieved.

The wanted and interfering signals apply to all supported polarizations, under the assumption of polarization match.

### 7.6.2 In-band blocking

In-band blocking is a measure of a receiver's ability to receive a NR signal at its assigned channel frequency in the presence of an interferer at a given frequency offset from the centre frequency of the assigned channel.

**Editor's note: The following aspects are either missing or not yet determined:**

- Measurement uncertainty is FFS for power class 1, 2 and 4.

#### 7.6.2.1 Test purpose

In-band blocking is defined for an unwanted interfering signal falling into the UE receive band or into the spectrum equivalent to twice the channel bandwidth below or above the UE receive band at which the relative throughput shall meet or exceed the minimum requirement for the specified measurement channels.

#### 7.6.2.2 Test applicability

This test applies to all types of NR UE release 15 and forward.

#### 7.6.2.3 Minimum conformance requirements

The throughput shall be  $\geq 95\%$  of the maximum throughput of the reference measurement channels as specified in Annexes A.2.3.2 and A.3.3.2 (with one sided dynamic OCN Pattern OP.1 TDD for the DL-signal as described in Annex A.5.2.1). The requirement is verified with the test metric of EIS (Link=RX beam peak direction, Meas=Link angle).

**Table 7.6.2.3-1: In-band blocking requirements**

Rx parameter	Units	Channel bandwidth			
		50 MHz	100 MHz	200 MHz	400 MHz
Power in Transmission Bandwidth Configuration	dBm	REFSENS + 14dB			
BW <sub>Interferer</sub>	MHz	50	100	200	400
P <sub>Interferer</sub> for bands n257, n258, n261	dBm	REFSENS + 35.5 dB	REFSENS + 35.5 dB	REFSENS + 35.5 dB	REFSENS + 35.5 dB
P <sub>Interferer</sub> for band n260	dBm	REFSENS + 34.5 dB	REFSENS + 34.5 dB	REFSENS + 34.5 dB	REFSENS + 34.5 dB
F <sub>offset</sub>	MHz	$\leq -100$ & $\geq 100$ NOTE 5	$\leq -200$ & $\geq 200$ NOTE 5	$\leq -400$ & $\geq 400$ NOTE 5	$\leq -800$ & $\geq 800$ NOTE 5
F <sub>Interferer</sub>	MHz	F <sub>DL_low</sub> + 25 to F <sub>DL_high</sub> - 25	F <sub>DL_low</sub> + 50 to F <sub>DL_high</sub> - 50	F <sub>DL_low</sub> + 100 to F <sub>DL_high</sub> - 100	F <sub>DL_low</sub> + 200 to F <sub>DL_high</sub> - 200
NOTE 1: The interferer consists of the Reference measurement channel specified in Annexes A.2.3.2 and A.3.3.2 (with one sided dynamic OCN Pattern OP.1 TDD for the DL-signal as described in Annex					

NOTE 2:	A.5.2.1) and set-up according to Annex C. The REFSENS power level is specified in Section 7.3.2.3, which are applicable according to different UE power classes.
NOTE 3:	The wanted signal consists of the reference measurement channel specified in Annexes A.2.3.2 and A.3.3.2 (with one sided dynamic OCNG Pattern OP.1 TDD for the DL-signal as described in Annex A.5.2.1) and set-up according to Annex C.
NOTE 4:	$F_{\text{offset}}$ is the frequency separation between the centre of the aggregated CA bandwidth and the centre frequency of the Interferer signal.
NOTE 5:	The absolute value of the interferer offset $F_{\text{offset}}$ shall be further adjusted $(\text{CEIL}( F_{\text{interferer}} /\text{SCS}) + 0.5) * \text{SCS}$ MHz with SCS the sub-carrier spacing of the wanted signal in MHz. Wanted and interferer signal have same SCS.
NOTE 6:	$F_{\text{interferer}}$ range values for unwanted modulated interfering signals are interferer centre frequencies.
NOTE 7:	The transmitter shall be set to 4 dB below the $P_{\text{UMAX},f,c}$ as defined in clause 6.2.4, with uplink configuration specified in Table 7.3.2.3.1-2.

The normative reference for this requirement is TS 38.101-2 [10] clause 7.6.2.

7.6.2.4 Test description

7.6.2.4.1 Initial conditions

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, test channel bandwidths and sub-carrier spacing based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each combination of channel bandwidth and sub-carrier spacing, are shown in Table 7.6.2.4.1-1. The details of the uplink and downlink reference measurement channels (RMC) are specified in Annexes A.2 and A.3. Configuration of PDSCH and PDCCH before measurement are specified in Annex C.2. The details of the OCNG patterns used are specified in Annex A.5.

**Table 7.6.2.4.1-1: Test Configuration Table**

Initial Conditions				
Test Environment as specified in TS 38.508-1 [10] subclause 4.1		Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1		Mid range		
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1		50 MHz, 100 MHz		
Test SCS as specified in Table 5.3.5-1		120 kHz		
Test Parameters				
Test ID	Downlink Configuration		Uplink Configuration	
	Modulation	RB allocation	Modulation	RB allocation
1	CP-OFDM QPSK	NOTE 1	DFT-s-OFDM QPSK	NOTE 1
NOTE 1: The specific configuration of each RB allocation is defined in Table 7.3.2.4.1-1.				

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, Figure A.3.3.1.2 for TE diagram and Figure A.3.4.1.1 for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C, and uplink signals according to Annex G.
4. The DL and UL Reference Measurement channels are set according to Table 7.6.2.4.1-1.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity NR, Connected without release On, Test Mode On and Test Loop Function On according to TS 38-508-1 [10] clause 4.5. Message content are defined in clause 7.6.2.4.3.

#### 7.6.2.4.2 Test procedure

1. Set the UE in the Rx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.2. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 1) for the UE Rx beam selection to complete.
2. SS transmits PDSCH via PDCCH DCI format 1\_1 for C\_RNTI to transmit the DL RMC according to Table 7.6.2.4.1-1. The SS sends downlink MAC padding bits on the DL RMC.
3. SS sends uplink scheduling information for each UL HARQ process via PDCCH DCI format 0\_1 for C\_RNTI to schedule the UL RMC according to Table 7.6.2.4.1-1. Since the UL has no payload and no loopback data to send the UE sends uplink MAC padding bits on the UL RMC.
4. Send Uplink power control commands to the UE (less or equal to 1dB step size should be used), to ensure that the UE output power measured by the test system is within the Uplink power control window, defined as  $-\text{MU}$  to  $-(\text{MU} + \text{Uplink power control window size})$  dB of the target power level in Table 7.6.2.5-1, for at least the duration of the throughput measurement, where:
  - MU is the test system uplink power measurement uncertainty and is specified in Table F.1.3-1 for the carrier frequency  $f$  and the channel bandwidth BW.
  - Uplink power control window size =  $1\text{dB (UE power step size)} + 1\text{dB (UE power step tolerance)} + (\text{Test system relative power measurement uncertainty})$ , where, the UE power step tolerance is specified in TS 38.101-2 [3], Table 6.3.4.3-2 and is 1dB for 1dB power step size, and the Test system relative power measurement uncertainty is specified in Table F.1.3-1.
5. Perform Blocking measurement procedure as stated in Annex K.1.8 using Downlink signal level and Interferer signal level as defined in Table 7.6.2.5-1. Modulated interferer signal characteristics as defined in Annex D. Measure throughput for a duration sufficient to achieve statistical significance according to Annex H.2.
6. Repeat step 5 using interfering signals specified in 7.6.2.5-1. The ranges are covered in steps equal to the interferer bandwidth. Interferer frequencies should be chosen starting with an offset nearest to the centre frequency and sweep outwards towards the band edges. In order to ensure that full range is tested for interferer frequency, run last test steps at frequency equal to  $F_{\text{Interferer}}$  range limit defined at the corresponding band edge.

NOTE 1: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.2.

**Table 7.6.2.4.2-1: Example for interferer frequencies**

	Lower frequency	Upper frequency
Band n257	26500.00 MHz	29500.00 MHz
Band n257 Midrange	27999.96 MHz	
SCS	120 kHz	
CHBW	100 MHz	
Interferer (1 <sup>st</sup> :most inner)	FFS	FFS
Interferer (2 <sup>nd</sup> )	FFS	FFS
:	:	:
Interferer (13 <sup>th</sup> )	FFS	FFS
Interferer (last step) <sup>NOTE 1</sup>	FFS	FFS
Outer limit for in band blocking	FFS	FFS
Number of test frequencies	14	14
NOTE 1: Adjusted interferer frequency in the last step will be out of outer limit but should be tested.		

#### 7.6.2.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6 with TRANSFORM\_PRECODER\_ENABLED condition in Table 4.6.3-118 PUSCH-Config.

#### 7.6.2.5 Test requirement

The throughput measurement derived in test procedure shall be  $\geq 95\%$  of the maximum throughput of the reference measurement channels as specified in Annex A with parameters specified in Table 7.6.2.5-1.

Table 7.6.2.5-1: In-band blocking test requirement

Rx parameter	Units	Channel bandwidth			
		50 MHz	100 MHz	200 MHz	400 MHz
Power in Transmission Bandwidth Configuration for bands n257, n258, n261	dBm	REFSENS + 14dB			
Power in Transmission Bandwidth Configuration for band n260	dBm	REFSENS + 14 - 1.8 dB NOTE 7	REFSENS + 14 - 4.8 dB NOTE 7	REFSENS + 14 dB	REFSENS + 14 dB
$BW_{\text{Interferer}}$	MHz	50	100	200	400
$P_{\text{Interferer}}$ for bands n257, n258, n261	dBm	REFSENS + 35.5 dB	REFSENS + 35.5 dB	REFSENS + 35.5 dB NOTE 8	REFSENS + 35.5 dB NOTE 8
$P_{\text{Interferer}}$ for band n260	dBm	REFSENS + 34.5 - 1.8 dB NOTE 7	REFSENS + 34.5 - 4.8 dB NOTE 7	REFSENS + 34.5 dB NOTE 8	REFSENS + 34.5 dB NOTE 8
$F_{\text{offset}}$	MHz	$\leq -100$ & $\geq 100$ NOTE 5	$\leq -200$ & $\geq 200$ NOTE 5	$\leq -400$ & $\geq 400$ NOTE 5	$\leq -800$ & $\geq 800$ NOTE 5
$F_{\text{Interferer}}$	MHz	$F_{\text{DL\_low}} + 25$ to $F_{\text{DL\_high}} - 25$	$F_{\text{DL\_low}} + 50$ to $F_{\text{DL\_high}} - 50$	$F_{\text{DL\_low}} + 100$ to $F_{\text{DL\_high}} - 100$	$F_{\text{DL\_low}} + 200$ to $F_{\text{DL\_high}} - 200$
<p>NOTE 1: The interferer consists of the Reference measurement channel specified in Annex A.3.3.2 with one sided dynamic OCNG Pattern OP.1.TDD as described in Annex A.5.2.1 and set-up according to Annex C.</p> <p>NOTE 2: The REFSENS power level is specified in Section 7.3.2.5, which are applicable according to different UE power classes.</p> <p>NOTE 3: The wanted signal consists of the reference measurement channel specified in Annex A.3.3.2 with one sided dynamic OCNG pattern OP.1.TDD as described in Annex A.5.2.1 and set-up according to Annex C.</p> <p>NOTE 4: <math>F_{\text{offset}}</math> is the frequency separation between the centre of the aggregated CA bandwidth and the centre frequency of the Interferer signal.</p> <p>NOTE 5: The absolute value of the interferer offset <math>F_{\text{offset}}</math> shall be further adjusted <math>(\text{CEIL}( F_{\text{Interferer}} /\text{SCS}) + 0.5) * \text{SCS}</math> MHz with SCS the sub-carrier spacing of the wanted signal in MHz. Wanted and interferer signal have same SCS.</p> <p>NOTE 6: <math>F_{\text{Interferer}}</math> range values for unwanted modulated interfering signals are interferer centre frequencies.</p> <p>NOTE 7: Core requirement cannot be tested due to testability issue and test requirement for wanted signal and interferer includes relaxation to achieve feasible interferer power level.</p> <p>NOTE 8: Core requirement cannot be tested due to testability issue.</p> <p>NOTE 9: The transmitter shall be set to 4 dB below the <math>P_{\text{UMAX},f,c}</math> as defined in clause 6.2.4, with uplink configuration specified in Table 7.3.2.3.1-2.</p>					

### 7.6.3 Void

## 7.6A Blocking characteristics for CA

### 7.6A.1 General

FFS

## 7.6A.2 In-band blocking for CA

### 7.6A.2.0 Minimum Conformance Requirements

#### 7.6A.2.0.1 In-band blocking for Intra-band contiguous CA

In-band blocking for Intra-band contiguous CA For intra-band contiguous carrier aggregation, the SCC(s) shall be configured at nominal channel spacing to the PCC. The input power shall be distributed among the active DL CCs so their PSDs are aligned with each other. The UE shall fulfil the minimum requirement specified in Table 7.6A.2.0.1-1 for in the presence of an interferer at a given frequency offset from the centre frequency of the assigned channel and an interferer power shall not exceed -25 dBm. The throughput of each carrier shall be  $\geq 95\%$  of the maximum throughput of the reference measurement channels as specified in Annexes A.2.3.2 and A.3.3.2 (with one sided dynamic OCNG Pattern OP.1 TDD for the DL-signal as described in Annex A.5.2.1). The requirement is verified with the test metric of EIS (Link=RX beam peak direction, Meas=Link angle).

**Table 7.6A.2.0.1-1: In band blocking minimum requirements for intra-band contiguous CA**

Rx Parameter	Units	All CA bandwidth classes
Power in Transmission Bandwidth Configuration, per CC		REFSENS + 14 dB
Pinterferer for band n257, n258, n261	dBm	Aggregated power + 21.5
Pinterferer for band n260	dBm	Aggregated power + 20.5
BW <sub>Interferer</sub>	MHz	BW <sub>Channel_CA</sub>
F <sub>offset</sub>	MHz	+2*BW <sub>Channel_CA</sub> / -2*BW <sub>Channel_CA</sub> NOTE 5
F <sub>Interferer</sub>	MHz	F <sub>DL_low</sub> + 0.5*BW <sub>Channel_CA</sub> To F <sub>DL_high</sub> - 0.5*BW <sub>Channel_CA</sub>
<p>NOTE 1: The interferer consists of the Reference measurement channel specified in Annex A.3.3.2 with one sided dynamic OCNG Pattern OP.1 TDD as described in Annex A.5.2.1. and set-up according to Annex C.</p> <p>NOTE 2: The REFSENS power level is specified in clause 7.3.2.</p> <p>NOTE 3: The wanted signal consists of the reference measurement channel specified in Annex A.3.3.2 QPSK, R=1/3 with one sided dynamic OCNG pattern OP.1 TDD as described in Annex A.5.2.1 and set-up according to Annex C.</p> <p>NOTE 4: The F<sub>Interferer</sub> (offset) is the frequency separation between the centre of the aggregated CA bandwidth and the centre frequency of the Interferer signal.</p> <p>NOTE 5: The absolute value of the interferer offset F<sub>Interferer</sub> (offset) shall be further adjusted to (CEIL( F<sub>Interferer</sub> /SCS) + 0.5)*SCS MHz with SCS the sub-carrier spacing of the carrier closest to the interferer in MHz. The interfering signal has the same SCS as that of the closest carrier.</p> <p>NOTE 6: F<sub>Interferer</sub> range values for unwanted modulated interfering signals are interferer centre frequencies.</p> <p>NOTE 7: The transmitter shall be set to 4 dB below the P<sub>UMAX,f,c</sub> as defined in clause 6.2.4, with uplink configuration specified in Table 7.3.2.3.1-2.</p>		

#### 7.6A.2.0.2 In-band blocking for Intra-band non-contiguous CA

For intra-band non-contiguous carrier aggregation with two component carriers, the requirement applies to out-of-gap and in-gap. For out-of-gap, the UE shall meet the requirements for each component carrier with parameters as specified in Table 7.6.2.3-1. The requirement associated to the maximum channel between across the component carriers is selected. For in-gap, the requirement shall apply if the following minimum gap condition is met:

$$\Delta f_{IBB} \geq 0.5(BW_1 + BW_2) + 2 \max(BW_1, BW_2),$$

where  $\Delta f_{IBB}$  is the frequency separation between the centre frequencies of the component carriers and  $BW_k$  are the channel bandwidths of carrier  $k$ ,  $k = 1, 2$ .

If the minimum gap condition is met, the UE shall meet the requirement specified in Table 7.6.2.3-1 for each component carrier. The respective channel bandwidth of the component carrier under test will be used in the parameter calculations of the requirement. In case of more than two component carriers, the minimum gap condition is computed for any pair of adjacent component carriers following the same approach as the two component carriers. The in-gap requirement for the corresponding pairs shall apply if the minimum gap condition is met. For every component carrier to which the requirements apply, the UE shall meet the requirement with one active interferer signal (in-gap or out-of-gap) while all downlink carriers are active and the input power shall be distributed among the active DL CCs so their PSDs are aligned with each other.

### 7.6A.2.0.3 In-band blocking for Inter-band CA

For inter-band carrier aggregation with one component carrier per operating band and the uplink assigned to one NR band, the in-band blocking requirements are defined with the uplink active on the band other than the band whose downlink is being tested. The UE shall meet the requirements specified in clause 7.6.2 for each component carrier while all downlink carriers are active.

#### 7.6A.2.1 In-band blocking for CA (2DL CA)

FFS

#### 7.6A.2.2 In-band blocking for CA (3DL CA)

FFS

#### 7.6A.2.3 In-band blocking for CA (4DL CA)

FFS

#### 7.6A.2.4 In-band blocking for CA (5DL CA)

FFS

#### 7.6A.2.5 In-band blocking for CA (6DL CA)

FFS

#### 7.6A.2.6 In-band blocking for CA (7DL CA)

FFS

#### 7.6A.2.7 In-band blocking for CA (8DL CA)

FFS

## 7.6D Blocking characteristics for UL MIMO

The normative reference for this requirement is TS 38.101-2 [3] clause 7.6D.

No test case details are specified. Given UE's Rx performance would not be impacted by the Tx configuration on TDD bands, the requirements in this test case can be well covered in 7.6 and don't need to be tested again.

## 7.7 Void

## 7.8 Void

## 7.9 Spurious emissions

Editor's note: Following aspects are either missing or not yet determined:

- The testability of this test case is pending further analysis on relaxation of the requirement for band other than n257, n258, n260 and n261.
- Measurement Uncertainties and Test Tolerances are FFS for power class 1, 2, and 4.
- Connection diagram between SS and UE in TS 38.508-1 [10] Annex A is FFS.
- Test procedure only includes the testing of smartphone and is FFS for laptop and FWA.

### 7.9.1 Test purpose

Test verifies the UE's spurious emissions meet the requirements described in clause 7.9.3.

Excess spurious emissions increase the interference to other systems.

### 7.9.2 Test applicability

This test case applies to all types of NR UE release 15 and forward.

### 7.9.3 Minimum conformance requirements

The spurious emissions power is the power of emissions generated or amplified in a receiver. The spurious emissions power level is measured as TRP.

The power of any narrow band CW spurious emission shall not exceed the maximum level specified in Table 7.9.3-1. The requirement is verified in beam locked mode with the test metric of TRP (Link=TX beam peak direction, Meas=TRP grid).

**Table 7.9.3-1: General receiver spurious emission requirements**

Frequency range	Measurement bandwidth	Maximum level	NOTE
$30\text{MHz} \leq f < 1\text{GHz}$	100 kHz	-57 dBm	1
$1\text{GHz} \leq f \leq 2^{\text{nd}}$ harmonic of the upper frequency edge of the DL operating band in GHz	1 MHz	-47 dBm	
NOTE 1: Unused PDCCH resources are padded with resource element groups with power level given by PDCCH as defined in Annex C.3.1.			

The normative reference for this requirement is TS 38.101-2 [3] clause 7.9.

### 7.9.4 Test description

#### 7.9.4.1 Initial conditions

Initial conditions are a set of test configurations the UE needs to be tested in and the steps for the SS to take with the UE to reach the correct measurement state.

The initial test configurations consist of environmental conditions, test frequencies, test channel bandwidths and sub-carrier spacing based on NR operating bands specified in Table 5.3.5-1. All of these configurations shall be tested with applicable test parameters for each combination of channel bandwidth and sub-carrier spacing, are shown in table



7.9.4.1-1. The details of the uplink and downlink reference measurement channels (RMC) are specified in Annexes A.2 and A.3. Configurations of PDSCH and PDCCH before measurement are specified in Annex C.2.

**Table 7.9.4.1-1: Test Configuration Table**

Default Conditions				
Test Environment as specified in TS 38.508-1 [10] subclause 4.1		Normal		
Test Frequencies as specified in TS 38.508-1 [10] subclause 4.3.1		Low range, Mid range, High range		
Test Channel Bandwidths as specified in TS 38.508-1 [10] subclause 4.3.1		Highest		
Test SCS as specified in Table 5.3.5-1		Highest		
Test Parameters				
Downlink Configuration			Uplink Configuration	
Test ID	Mod'n	RB allocation	Mod'n	RB allocation
1	-	-	-	-
NOTE 1: The specific configuration of uplink and downlink are defined in Table 7.3.2.4.1-1.				

1. Connection between SS and UE is shown in TS 38.508-1 [10] Annex A, [Figure TBD] for TE diagram and [Figure TBD] for UE diagram.
2. The parameter settings for the cell are set up according to TS 38.508-1 [10] subclause 4.4.3.
3. Downlink signals are initially set up according to Annex C , and uplink signals according to Annex G.
4. The DL and UL Reference Measurement channels are set according to Table 7.9.4.1-1.
5. Propagation conditions are set according to Annex B.0.
6. Ensure the UE is in state RRC\_CONNECTED with generic procedure parameters Connectivity NR, Connected without release *On*, Test Mode *On* and Test Loop Function *On* according to TS 38.508-1 [10] clause 4.5. Message content are defined in clause 7.9.4.3.

#### 7.9.4.2 Test procedure

1. Select any of the three Alignment Options (1, 2, or 3) from Tables N.2-1 through N.2-3 to mount the DUT inside the QZ.
2. If the re-positioning concept is applied, position the device in DUT Orientation 1 if the maximum beam peak direction is within zenith angular range  $0^\circ \leq \theta \leq 90^\circ$  for the alignment option selected in step 1; position the device in DUT Orientation 2 (either Options 1 or 2) if the maximum beam peak direction is within zenith angular range  $90^\circ < \theta \leq 180^\circ$  for DUT Orientation 1 for the alignment option selected in step 1. If the re-positioning concept is not applied, position the device in DUT Orientation 1.
3. Set the UE in the Inband Tx beam peak direction found with a 3D EIRP scan as performed in Annex K.1.1 using the uplink configuration in section 6.2.1.1. Allow at least BEAM\_SELECT\_WAIT\_TIME (NOTE 3) for the UE Tx beam selection to complete.
4. SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
5. Measure the spurious emissions as per steps outlined below with an exception to the procedure in Annex K if the re-positioning concept is applied (NOTE 4). Step (a) is optional and applicable only if SNR (test requirement level in Table 7.9.5-1 minus offset value minus noise floor of the test system)  $\geq 0$  dB is guaranteed.
  - (a) Perform coarse TRP measurements to identify spurious emission frequencies and corresponding power level according to the procedures in Annex K, using coarse TRP measurement grid selection criteria as per Table M.4.5-3 in Annex M. The measurement is completed in both polarizations  $\theta$  and  $\phi$  over frequency range and measurement bandwidth according to Table 7.9.5-1. Optionally, a larger and non-constant measurement bandwidth than that of Table 7.9.5-1 may be applied. The measurement period shall capture the active time slots. For each spurious emission frequency with coarse TRP identified to be less than an offset dB from the TRP limit according to Table 7.9.5-1, continue with fine TRP procedures according to step (b).

The offset value shall be the TRP measurement uncertainty at 95% confidence level including the effect of coarse grid measurement uncertainty element, excluding the influence of noise. Different coarse TRP grids and corresponding offset values may be used for different frequencies. The coarse TRP grid and offset values used shall be recorded in the test report.

**Table 7.9.4.2-1: Typical offset values for coarse TRP measurement step 7(a)**

Grid	Frequency Range	Offset Value
Constant Density	$6 \text{ GHz} \leq f < 12.75 \text{ GHz}$	5.25
	$12.75 \text{ GHz} \leq f < 23.45 \text{ GHz}$	5.21
	$23.45 \text{ GHz} \leq f < 40.8 \text{ GHz}$	5.49
	$40.8 \text{ GHz} \leq f < 66 \text{ GHz}$	7.31
	$66 \text{ GHz} \leq f \leq 80 \text{ GHz}$	7.61
Constant-Step Size	$6 \text{ GHz} \leq f < 12.75 \text{ GHz}$	5.38
	$12.75 \text{ GHz} \leq f < 23.45 \text{ GHz}$	5.34
	$23.45 \text{ GHz} \leq f < 40.8 \text{ GHz}$	5.62
	$40.8 \text{ GHz} \leq f < 66 \text{ GHz}$	7.43
	$66 \text{ GHz} \leq f \leq 80 \text{ GHz}$	7.73
NOTE 1: These offset values are the upper limit values when fine TRP measurement uncertainty of the test system is same as maximum test system uncertainty in Annex F and when using the coarse measurement grid with minimum number of points as specified in Table M.4.5-3.		
NOTE 2: It is allowed to use the offset values derived based on test system's actual measurement uncertainty budget and denser measurement grid as specified in Table M.4.5-3.		

(b) Measure fine TRP measurements according to procedures in Annex K, using fine TRP measurement grid selection criteria as per Table M.4.5-3 in Annex M, for each of the spurious emission frequency identified in step (a). Apply a measurement bandwidth according to Table 7.9.5-1.

6. SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

NOTE 1: The frequency range defined in Table 7.9.5-1 may be split into ranges. For each range a different test system, e.g. antenna and/or chamber, may be used. To pass the test case all verdicts of the frequency ranges must pass.

NOTE 2: Void.

NOTE 3: The BEAM\_SELECT\_WAIT\_TIME default value is defined in Annex K.1.1.

NOTE 4: If the (in-band) beam peak is within  $0^\circ \leq \theta \leq 90^\circ$ : perform first hemispherical TRP scan ( $0^\circ \leq \theta \leq 90^\circ$ ) in DUT Orientation 1 and second hemispherical TRP scan ( $90^\circ > \theta \geq 0^\circ$ ) in DUT Orientation 2. If the (in-band) beam peak is within  $90^\circ < \theta \leq 180^\circ$ : perform first hemispherical TRP scan ( $0^\circ \leq \theta \leq 90^\circ$ ) in DUT Orientation 2 and second hemispherical TRP scan ( $90^\circ > \theta \geq 0^\circ$ ) in DUT Orientation 1. The DUT with UBF activated needs to be re-positioned during the test.

NOTE 5: The coarse TRP measurement grid and corresponding offset dB value referred in step 5(a) above, for some valid grids can be found in TR 38.903[20] section B.18.

#### 7.9.4.3 Message contents

Message contents are according to TS 38.508-1 [10] subclause 4.6.

#### 7.9.5 Test requirement

The measured spurious emissions derived in step 5, shall not exceed the maximum level specified in Table 7.9.5-1.

**Table 7.9.5-1: General receiver spurious emission requirements (Band n257, n258, n260, n261)**

Frequency range	Measurement bandwidth	Maximum level	NOTE
$6 \text{ GHz} \leq f < 20 \text{ GHz}$	1 MHz	$-47 + 10.2$	1

		dBm	
$20\text{GHz} \leq f < 40\text{GHz}$	1 MHz	$-47 + 17.2$ dBm	1
$40\text{GHz} \leq f \leq 2^{\text{nd}}$ harmonic of the upper frequency edge of the DL operating band in GHz	1 MHz	$-47 + 33.1$ dBm	1
NOTE 1: Unused PDCCH resources are padded with resource element groups with power level given by PDCCH as defined in Annex C.3.1.			

**Table 7.9.5-2: Void**

## 7.10 Void

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## Annex A (normative): Measurement channels

### A.1 General

TBD

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### A.2 UL reference measurement channels

#### A.2.1 General

TBD

#### A.2.2 Void

## A.2.3 Reference measurement channels for TDD

For UL RMCs defined below, TDD slot pattern defined in Table A.2.3-1 will be used for the requirements requiring at least one sub frame (1 ms) for the measurement period. For other requirements, TDD slot patterns defined for reference sensitivity tests in Table A.3.3.1-1 will be used.

**Table A.2.3-1: Additional reference channels parameters for TDD**

Parameter		Value	
		SCS 60 kHz ( $\mu=2$ )	SCS 120 kHz ( $\mu=3$ )
TDD Slot Configuration pattern (Note 1)		DDDSUUUU	7DS8U
Special Slot Configuration (Note 2)		S=4D+6G+4U	S=12D+2G
UL-DL configuration	<i>referenceSubcarrierSpacing</i>	60 kHz	120 kHz
	<i>dl-UL-TransmissionPeriodicity</i>	2 ms	2 ms
	<i>nrofDownlinkSlots</i>	3	7
	<i>nrofDownlinkSymbols</i>	4	12
	<i>nrofUplinkSlot</i>	4	8
	<i>nrofUplinkSymbols</i>	4	0
<i>UL slot numbers</i>		mod(slot index, 40) = {36,...,39}	mod(slot index, 80) = {72,...,79}
NOTE 1: D denotes a slot with all DL symbols; S denotes a slot with a mix of DL, UL and guard symbols; U denotes a slot with all UL symbols. The field is for information.			
NOTE 2: D, G, U denote DL, guard and UL symbols, respectively. The field is for information.			

### A.2.3.1 DFT-s-OFDM Pi/2-BPSK

**Table A.2.3.1-1: Reference Channels for DFT-s-OFDM pi/2-BPSK**

Parameter	Allocated resource blocks (L <sub>CRB</sub> )	DFT-s-OFDM Symbols per slot (Note 1)	Modulation	MCS Index (Note 2)	Payload size	Transport block CRC	LDPC Base Graph	Number of code blocks per slot (Note 3)	Total number of bits per slot	Total modulated symbols per slot
Unit					Bits	Bits			Bits	
	1	11	pi/2 BPSK	0	24	16	2	1	132	132
	16	11	pi/2 BPSK	0	504	16	2	1	2112	2112
	32	11	pi/2 BPSK	0	1032	16	2	1	4224	4224
	64	11	pi/2 BPSK	0	2024	16	2	1	8448	8448
	128	11	pi/2 BPSK	0	3976	24	2	2	16896	16896
	256	11	pi/2 BPSK	0	7944	24	2	3	33792	33792
NOTE 1: PUSCH mapping Type-A and single-symbol DM-RS configuration Type-1 with 2 additional DM-RS symbols, such that the										

DM-RS positions are set to symbols 2, 7, 11. DMRS is [TDM'ed] with PUSCH data. DM-RS symbols are not counted.
NOTE 2: MCS Index is based on MCS table 6.1.4.1-1 defined in 38.214.
NOTE 3: If more than one Code Block is present, an additional CRC sequence of L = 24 Bits is attached to each Code Block (otherwise L = 0 Bit)
NOTE 4: Indexes of active UL slots are given by Table A.2.3-1 with TDD UL-DL configuration specified in A2.3 for the requirements requiring at least one sub frame (1ms) for the measurement period. For other requirements, indexes of active UL slots are given by the slots satisfying $\text{mod}(\text{slot index}+1, 5) = 0$ with TDD UL-DL configuration specified in A.3.3.1.
NOTE 5: The RMCs apply to all channel bandwidth where $L_{\text{CRB}} \leq N_{\text{RB}}$ .

Table A.2.3.1-2: Void

## A.2.3.2 DFT-s-OFDM QPSK

Table A.2.3.2-1: Reference Channels for DFT-s-OFDM QPSK

Parameter	Allocated resource blocks ( $L_{\text{CRB}}$ )	DFT-s-OFDM Symbols per slot (Note 1)	Modulation	MCS Index (Note 2)	Payload size	Transport block CRC	LDPC Base Graph	Number of code blocks per slot (Note 3)	Total number of bits per slot	Total modulated symbols per slot
Unit					Bits	Bits			Bits	
	1	11	QPSK	2	48	16	2	1	264	132
	16	11	QPSK	2	808	16	2	1	4224	2112
	20	11	QPSK	2	1032	16	2	1	5280	2640
	32	11	QPSK	2	1608	16	2	1	8448	4224
	64	11	QPSK	2	3240	16	2	1	16896	8448
	128	11	QPSK	2	6408	24	2	2	33792	16896
	256	11	QPSK	2	12808	24	2	4	67584	33792

NOTE 1: PUSCH mapping Type-A and single-symbol DM-RS configuration Type-1 with 2 additional DM-RS symbols, such that the DM-RS positions are set to symbols 2, 7, 11. DMRS is [TDM'ed] with PUSCH data. DM-RS symbols are not counted.

NOTE 2: MCS Index is based on MCS table 6.1.4.1-1 defined in 38.214.

NOTE 3: If more than one Code Block is present, an additional CRC sequence of L = 24 Bits is attached to each Code Block (otherwise L = 0 Bit)

NOTE 4: Indexes of active UL slots are given by Table A.2.3-1 with TDD UL-DL configuration specified in A2.3 for the requirements requiring at least one sub frame (1ms) for the measurement period. For other requirements, indexes of active UL slots are given by the slots satisfying  $\text{mod}(\text{slot index}+1, 5) = 0$  with TDD UL-DL configuration specified in A.3.3.1.

NOTE 5: The RMCs apply to all channel bandwidth where  $L_{\text{CRB}} \leq N_{\text{RB}}$ .

Table A.2.3.2-2: Void

## A.2.3.3 DFT-s-OFDM 16QAM

Table A.2.3.3-1: Reference Channels for DFT-s-OFDM 16QAM

Parameter	Allocated resource blocks (L <sub>CRB</sub> )	DFT-s-OFDM Symbols per slot (Note 1)	Modulation	MCS Index (Note 2)	Payload size	Transport block CRC	LDPC Base Graph	Number of code blocks per slot (Note 3)	Total number of bits per slot	Total modulated symbols per slot
Unit					Bits	Bits			Bits	
	1	11	16QAM	10	176	16	2	1	528	132
	16	11	16QAM	10	2792	16	2	1	8448	2112
	32	11	16QAM	10	5632	24	1	1	16896	4224
	64	11	16QAM	10	11272	24	1	2	33792	8448
	128	11	16QAM	10	22536	24	1	3	67584	16896
	256	11	16QAM	10	45096	24	1	6	135168	33792
NOTE 1: PUSCH mapping Type-A and single-symbol DM-RS configuration Type-1 with 2 additional DM-RS symbols, such that the DM-RS positions are set to symbols 2, 7, 11. DMRS is [TDM'ed] with PUSCH data. DM-RS symbols are not counted.										
NOTE 2: MCS Index is based on MCS table 6.1.4.1-1 defined in 38.214.										
NOTE 3: If more than one Code Block is present, an additional CRC sequence of L = 24 Bits is attached to each Code Block (otherwise L = 0 Bit)										
NOTE 4: Indexes of active UL slots are given by Table A.2.3-1 with TDD UL-DL configuration specified in A2.3 for the requirements requiring at least one sub frame (1ms) for the measurement period. For other requirements, indexes of active UL slots are given by the slots satisfying mod(slot index+1, 5) = 0 with TDD UL-DL configuration specified in A.3.3.1.										
NOTE 5: The RMCs apply to all channel bandwidth where L <sub>CRB</sub> ≤ N <sub>RB</sub> .										

Table A.2.3.3-2: Void

## A.2.3.4 DFT-s-OFDM 64QAM

Table A.2.3.4-1: Reference Channels for DFT-s-OFDM 64QAM

Parameter	Allocated resource blocks (L <sub>CRB</sub> )	DFT-s-OFDM Symbols per slot	Modulation	MCS Index (Note 2)	Payload size	Transport block CRC	LDPC Base Graph	Number of code blocks per slot	Total number of bits per slot	Total modulated symbols per slot
-----------	---	-----------------------------	------------	--------------------	--------------	---------------------	-----------------	--------------------------------	-------------------------------	----------------------------------

		(Note 1)						(Note 3)		
Unit					Bits	Bits			Bits	
	1	11	64QAM	18	408	16	2	1	792	132
	16	11	64QAM	18	6400	24	1	1	12672	2112
	32	11	64QAM	18	12808	24	1	2	25344	4224
	64	11	64QAM	18	25608	24	1	4	50688	8448
	128	11	64QAM	18	51216	24	1	7	101376	16896
	256	11	64QAM	18	102416	24	1	13	202752	33792

NOTE 1: PUSCH mapping Type-A and single-symbol DM-RS configuration Type-1 with 2 additional DM-RS symbols, such that the DM-RS positions are set to symbols 2, 7, 11. DMRS is [TDM'ed] with PUSCH data. DM-RS symbols are not counted.

NOTE 2: MCS Index is based on MCS table 6.1.4.1-1 defined in 38.214.

NOTE 3: If more than one Code Block is present, an additional CRC sequence of L = 24 Bits is attached to each Code Block (otherwise L = 0 Bit)

NOTE 4: Indexes of active UL slots are given by Table A.2.3-1 with TDD UL-DL configuration specified in A2.3 for the requirements requiring at least one sub frame (1ms) for the measurement period. For other requirements, indexes of active UL slots are given by the slots satisfying  $\text{mod}(\text{slot index}+1, 5) = 0$  with TDD UL-DL configuration specified in A.3.3.1.

NOTE 5: The RMCs apply to all channel bandwidth where  $L_{\text{CRB}} \leq N_{\text{RB}}$ .

Table A.2.3.4-2: Void

## A.2.3.5 CP-OFDM QPSK

Table A.2.3.5-1: Reference Channels for CP-OFDM QPSK

Parameter	Allocated resource blocks ( $L_{\text{CRB}}$ )	DFT-s-OFDM Symbols per slot (Note 1)	Modulation	MCS Index (Note 2)	Payload size	Transport block CRC	LDPC Base Graph	Number of code blocks per slot (Note 3)	Total number of bits per slot	Total modulated symbols per slot
Unit					Bits	Bits			Bits	
	1	11	QPSK	2	48	16	2	1	264	132
	16	11	QPSK	2	808	16	2	1	4224	2112
	32	11	QPSK	2	1608	16	2	1	8448	4224
	33	11	QPSK	2	1672	16	2	1	8712	4356
	66	11	QPSK	2	3368	16	2	1	17424	8712
	132	11	QPSK	2	6536	24	2	2	34848	17424
	264	11	QPSK	2	13064	24	2	4	69696	34848

NOTE 1: PUSCH mapping Type-A and single-symbol DM-RS configuration Type-1 with 2 additional DM-RS symbols, such that the DM-RS positions are set to symbols 2, 7, 11. DMRS is [TDM'ed] with PUSCH data. DM-RS symbols are not counted.

NOTE 2: MCS Index is based on MCS table 5.1.3.1-1 defined in 38.214.

NOTE 3: If more than one Code Block is present, an additional CRC sequence of L = 24 Bits is attached to each Code Block (otherwise L = 0 Bit)

NOTE 4: Indexes of active UL slots are given by Table A.2.3-1 with TDD UL-DL configuration specified in A2.3 for the requirements



requiring at least one sub frame (1ms) for the measurement period. For other requirements, indexes of active UL slots are given by the slots satisfying  $\text{mod}(\text{slot index}+1, 5) = 0$  with TDD UL-DL configuration specified in A.3.3.1.

NOTE 5: The RMCs apply to all channel bandwidth where  $L_{\text{CRB}} \leq N_{\text{RB}}$ .

Table A.2.3.5-2: Void

## A.2.3.6 CP-OFDM 16QAM

Table A.2.3.6-1: Reference Channels for CP-OFDM 16QAM

Parameter	Allocated resource blocks ( $L_{\text{CRB}}$ )	DFT-s-OFDM Symbols per slot (Note 1)	Modulation	MCS Index (Note 2)	Payload size	Transport block CRC	LDPC Base Graph	Number of code blocks per slot (Note 3)	Total number of bits per slot	Total modulated symbols per slot
Unit					Bits	Bits			Bits	
	1	11	16QAM	10	176	16	2	1	528	132
	16	11	16QAM	10	2792	16	2	1	8448	2112
	32	11	16QAM	10	5632	24	1	1	16896	4224
	33	11	16QAM	10	5760	24	1	1	17424	4356
	66	11	16QAM	10	11528	24	1	2	34848	8712
	132	11	16QAM	10	23040	24	1	3	69696	17424
	264	11	16QAM	10	46104	24	1	6	139392	34848

NOTE 1: PUSCH mapping Type-A and single-symbol DM-RS configuration Type-1 with 2 additional DM-RS symbols, such that the DM-RS positions are set to symbols 2, 7, 11. DM-RS is [TDM'ed] with PUSCH data. DM-RS symbols are not counted.

NOTE 2: MCS Index is based on MCS table 5.1.3.1-1 defined in 38.214.

NOTE 3: If more than one Code Block is present, an additional CRC sequence of  $L = 24$  Bits is attached to each Code Block (otherwise  $L = 0$  Bit)

NOTE 4: Indexes of active UL slots are given by Table A.2.3-1 with TDD UL-DL configuration specified in A.2.3 for the requirements requiring at least one sub frame (1ms) for the measurement period. For other requirements, indexes of active UL slots are given by the slots satisfying  $\text{mod}(\text{slot index}+1, 5) = 0$  with TDD UL-DL configuration specified in A.3.3.1.

NOTE 5: The RMCs apply to all channel bandwidth where  $L_{\text{CRB}} \leq N_{\text{RB}}$ .

Table A.2.3.6-2: Void

## A.2.3.7 CP-OFDM 64QAM

Table A.2.3.7-1: Reference Channels for CP-OFDM 64QAM

Parameter	Allocated	DFT-s-	Modulation	MCS	Payload	Transport	LDPC	Number	Total	Total
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	resource blocks (L <sub>CRB</sub> )	OFDM Symbols per slot (Note 1)		Index (Note 2)	size	block CRC	Base Graph	of code blocks per slot (Note 3)	number of bits per slot	modulated symbols per slot
Unit					Bits	Bits			Bits	
	1	11	64QAM	19	408	16	2	1	792	132
	16	11	64QAM	19	6400	24	1	1	12672	2112
	32	11	64QAM	19	12808	24	1	2	25344	4224
	33	11	64QAM	19	13064	24	1	2	26136	4356
	66	11	64QAM	19	26120	24	1	4	52272	8712
	132	11	64QAM	19	53288	24	1	7	104544	17424
	264	11	64QAM	19	106576	24	1	13	209088	34848
<p>NOTE 1: PUSCH mapping Type-A and single-symbol DM-RS configuration Type-1 with 2 additional DM-RS symbols, such that the DM-RS positions are set to symbols 2, 7, 11. DMRS is [TDM'ed] with PUSCH data. DM-RS symbols are not counted.</p> <p>NOTE 2: MCS Index is based on MCS table 5.1.3.1-1 defined in 38.214.</p> <p>NOTE 3: If more than one Code Block is present, an additional CRC sequence of L = 24 Bits is attached to each Code Block (otherwise L = 0 Bit)</p> <p>NOTE 4: Indexes of active UL slots are given by Table A.2.3-1 with TDD UL-DL configuration specified in A2.3 for the requirements requiring at least one sub frame (1ms) for the measurement period. For other requirements, indexes of active UL slots are given by the slots satisfying <math>\text{mod}(\text{slot index}+1, 5) = 0</math> with TDD UL-DL configuration specified in A.3.3.1.</p> <p>NOTE 5: The RMCs apply to all channel bandwidth where <math>L_{\text{CRB}} \leq N_{\text{RB}}</math>.</p>										

Table A.2.3.7-2: Void

## A.3 DL reference measurement channels

### A.3.1 General

Unless otherwise stated, Tables A.3.3.2-1 and A.3.3.2-2 are applicable for measurements of the Receiver Characteristics (clause 7).

Unless otherwise stated, Tables A.3.3.2-1 and A.3.3.2-2 also apply for the modulated interferer used in Clauses 7.5 and 7.6 with test specific bandwidths.

CSI-RS configuration parameter defined in A.3.1-2 is used for verifying the beam correspondence requirement, 2 slots of CSI-RS shall be provided at each test grid point. The DL channel shall be configured for zero power on all tones except those used by CSI-RS in slots containing CSI-RS for beam refinement, and the DL and UL channel sizes shall be the same during verification.

**Table A.3.1-1: Test parameters**

Parameter		Unit	Value
CORESET frequency domain allocation			Full BW
CORESET time domain allocation			2 OFDM symbols at the begin of each slot
PDSCH mapping type			Type A
PDSCH start symbol index (S)			2
Number of consecutive PDSCH symbols (L)			12
PDSCH PRB bundling		PRBs	2
Dynamic PRB bundling			false
MCS table for TBS determination			64QAM
Overhead value for TBS determination			0
First DMRS position for Type A PDSCH mapping			2
DMRS type			Type 1
Number of additional DMRS			2
FDM between DMRS and PDSCH			Disable
CSI-RS for tracking	First subcarrier index in the PRB used for CSI-RS ( $k_0$ )		0 for CSI-RS resource 1,2
	OFDM symbols in the PRB used for CSI-RS		10 = 8 for CSI-RS resource 1 10 = 12 for CSI-RS resource 2
	Number of CSI-RS ports		1 for CSI-RS resource 1,2
	CDM Type		'No CDM' for CSI-RS resource 1,2
	Density ( $\rho$ )		3 for CSI-RS resource 1,2
	CSI-RS periodicity	Slots	60 kHz SCS: 80 for CSI-RS resources 1 and 2 120 kHz SCS: 160 for CSI-RS resources 1 and 2
	CSI-RS offset	Slots	60 kHz SCS: 40 for CSI-RS resources 1 and 2 120kHz SCS: 80 for CSI-RS resources 1 and 2
	Frequency Occupation		Start PRB 0 Number of PRB = BWP size
	QCL info		TCI state #0
PTRS configuration			PTRS is not configured

**Table A.3.1-2: CSI-RS parameters**

Resource Type	aperiodic
<b>Resource Set Config</b>	
repetition	on
aperiodicTriggeringOffset	Depending on UE capability
<b>Resource Config</b>	
nzp-CSI-RS-ResourceId	30 for resource #0
	31 for resource #1
	32 for resource #2
	33 for resource #3
	34 for resource #4
	35 for resource #5

	36 for resource #6
	37 for resource #7
powerControlOffset	0
powerControlOffsetSS	db0
nrofPorts	1
firstOFDMSymbolInTimeDomain	6 for resource #0
	7 for resource #1
	8 for resource #2
	9 for resource #3
	10 for resource #4
	11 for resource #5
	12 for resource #6
13 for resource #7	
cdm-Type	noCDM
density	3
nrofRBs	48 for channel bandwidth≥100MHz 32 for channel bandwidth=50MHz
qcl-info	Type D to SSB

The CSI-RS configuration parameter defined in Table A.3.1-3 is used for verifying the beam correspondence requirement. CSI-RS shall be provided once every 10msec.

**Table A.3.1-3: CSI-RS parameters for CSI-RS based beam correspondence**

Resource Type	aperiodic
<b>Resource Set Config</b>	
repetition	on
aperiodicTriggeringOffset	Depending on UE capability
<b>Resource Config</b>	
nzp-CSI-RS-ResourceId	30 for resource #0
	31 for resource #1
	32 for resource #2
	33 for resource #3
	...
	...
	...
	29+N for resource #(N-1), where N is <i>maxNumberRxBeam</i> in UE capability IE of <i>MIMO-ParametersPerBand</i>
powerControlOffset	0
powerControlOffsetSS	db0
nrofPorts	1
firstOFDMSymbolInTimeDomain	6 for resource #0
	7 for resource #1
	8 for resource #2
	9 for resource #3
	...
	...
	...
	5+N for resource #(N-1), where N= <i>maxNumberRxBeam-1</i> in UE capability IE of <i>MIMO-ParametersPerBand</i>
cdm-Type	noCDM
density	3
nrofRBs	48 for channel bandwidth≥100MHz 32 for channel bandwidth=50MHz
qcl-info	Type D to SSB

## A.3.2 Void

## A.3.3 DL reference measurement channels for TDD

### A.3.3.1 General

**Table A.3.3.1-1: Additional test parameters for TDD**

Parameter		Value	
		SCS 60 kHz ( $\mu=2$ )	SCS 120 kHz ( $\mu=3$ )
UL-DL configuration	<i>referenceSubcarrierSpacing</i>	60 kHz	120 kHz
	<i>dl-UL-TransmissionPeriodicity</i>	1.25 ms	0.625 ms
	<i>nrofDownlinkSlots</i>	3	3
	<i>nrofDownlinkSymbols</i>	4	10
	<i>nrofUplinkSlot</i>	1	1
	<i>nrofUplinkSymbols</i>	4	2
Number of HARQ Processes		8	8
K1 value		K1 = 4 if mod(i,5) = 0 K1 =3 if mod(i,5) = 1 K1 =7 if mod(i,5) = 2 where i is slot index per frame; i = {0,...,39}	K1 = 4 if mod(i,5) = 0 K1 =3 if mod(i,5) = 1 K1 =7 if mod(i,5) = 2 where i is slot index per frame; i = {0,...,79}

### A.3.3.2 FRC for receiver requirements for QPSK

**Table A.3.3.2-1: Fixed Reference Channel for Receiver Requirements (SCS 60 kHz, TDD)**

Parameter	Unit	Value		
Channel bandwidth	MHz	50	100	200
Subcarrier spacing configuration $\mu$		2	2	2
Allocated resource blocks		66	132	264
Subcarriers per resource block		12	12	12
Allocated slots per Frame (NOTE 7)		23 / 24	23 / 24	23 / 24
MCS index		4	4	4
Modulation		QPSK	QPSK	QPSK
Target Coding Rate		1/3	1/3	1/3
Maximum number of HARQ transmissions		1	1	1
Information Bit Payload per Slot				
For Slots 0 and Slot i, if mod(i, 5) = {3,4} for i from {0,...,79} (NOTE 5)	Bits	N/A	N/A	N/A
For Slot i, if mod(i, 5) = {0,1,2} for i from {1,...,79} (NOTE 6)	Bits	4224	8456	16896
Transport block CRC	Bits	24	24	24
LDPC base graph		1	1	1
Number of Code Blocks per Slot				
For Slots 0 and Slot i, if mod(i, 5) = {3,4} for i from {0,...,79} (NOTE 5)	CBs	N/A	N/A	N/A
For Slot i, if mod(i, 5) = {0,1,2} for i from {1,...,79} (NOTE 6)	CBs	1	2	2
Binary Channel Bits Per Slot				
For Slots 0 and Slot i, if mod(i, 5) = {3,4} for i from {0,...,79} (NOTE 5)	Bits	N/A	N/A	N/A
For Slot i, if mod(i, 5) = {0,1,2} for i from {1,...,79} (NOTE 6)	Bits	14256	28512	57024
Max. Throughput averaged over 1 frame (NOTE 8)	Mbps	10.138	20.294	40.550
Note 1: Additional parameters are specified in Table A.3.1-1 and Table A.3.3.1-1.				
Note 2: If more than one Code Block is present, an additional CRC sequence of L = 24 Bits is attached to each Code Block (otherwise L = 0 Bit).				
Note 3: SS/PBCH block is transmitted in slot 0 with periodicity 20 ms				
Note 4: Slot i is slot index per 2 frames				

Note 5: When this DL RMC used together with the UL RMC for the transmitter requirements requiring at least one sub frame (1ms) for the measurement period, Slot i, if  $\text{mod}(i, 8) = \{3,4,5,6,7\}$  for i from  $\{0, \dots, 79\}$  together with the TDD UL-DL configuration specified in A2.3.

Note 6: When this DL RMC used together with the UL RMC for the transmitter requirements requiring at least one sub frame (1ms) for the measurement period, Slot i, if  $\text{mod}(i, 8) = \{0,1,2\}$  for i from  $\{0, \dots, 79\}$  together with the TDD UL-DL configuration specified in A2.3.

NOTE 7: First number corresponds to the number slots allocated in the first frame of the RMC; second number corresponds to the number slots allocated in the second frame of the RMC.

NOTE 8: Throughput is averaged over 2nd frame of RMC.

**Table A.3.3.2-2: Fixed Reference Channel for Receiver Requirements (SCS 120 kHz, TDD)**

Parameter	Unit	Value			
		50	100	200	400
Channel bandwidth	MHz	50	100	200	400
Subcarrier spacing configuration $\mu$		3	3	3	3
Allocated resource blocks		32	66	132	264
Subcarriers per resource block		12	12	12	12
Allocated slots per Frame (NOTE 7)		47 / 48	47 / 48	47 / 48	47 / 48
MCS index		4	4	4	4
Modulation		QPSK	QPSK	QPSK	QPSK
Target Coding Rate		1/3	1/3	1/3	1/3
Maximum number of HARQ transmissions		1	1	1	1
Information Bit Payload per Slot					
For Slots 0 and Slot i, if $\text{mod}(i, 5) = \{3,4\}$ for i from $\{0, \dots, 159\}$ (NOTE 5)	Bits	N/A	N/A	N/A	N/A
For Slot i, if $\text{mod}(i, 5) = \{0,1,2\}$ for i from $\{1, \dots, 159\}$ (NOTE 6)	Bits	2088	4224	8456	16896
Transport block CRC	Bits	16	24	24	24
LDPC base graph		2	1	1	1
Number of Code Blocks per Slot					
For Slots 0 and Slot i, if $\text{mod}(i, 5) = \{3,4\}$ for i from $\{0, \dots, 159\}$ (NOTE 5)	CBs	N/A	N/A	N/A	N/A
For Slot i, if $\text{mod}(i, 5) = \{0,1,2\}$ for i from $\{1, \dots, 159\}$ (NOTE 6)	CBs	1	1	2	2
Binary Channel Bits Per Slot					
For Slots 0 and Slot i, if $\text{mod}(i, 5) = \{3,4\}$ for i from $\{0, \dots, 159\}$ (NOTE 5)	Bits	N/A	N/A	N/A	N/A
For Slot i, if $\text{mod}(i, 5) = \{0,1,2\}$ for i from $\{1, \dots, 159\}$ (NOTE 6)	Bits	6912	14256	28512	57024
Max. Throughput averaged over 1 frame (NOTE 8)	Mbps	10.022	20.275	40.589	81.101
<p>Note 1: Additional parameters are specified in Table A.3.1-1 and Table A.3.3.1-1.</p> <p>Note 2: If more than one Code Block is present, an additional CRC sequence of L = 24 Bits is attached to each Code Block (otherwise L = 0 Bit).</p> <p>Note 3: SS/PBCH block is transmitted in slot 0 with periodicity 20 ms</p> <p>Note 4: Slot i is slot index per 2 frames</p> <p>Note 5: When this DL RMC used together with the UL RMC for the transmitter requirements requiring at least one sub frame (1ms) for the measurement period, Slot i, if <math>\text{mod}(i, 16) = \{7, \dots, 15\}</math> for i from <math>\{0, \dots, 159\}</math> together with the TDD UL-DL configuration specified in A2.3.</p> <p>Note 6: When this DL RMC used together with the UL RMC for the transmitter requirements requiring at least one sub frame (1ms) for the measurement period, Slot i, if <math>\text{mod}(i, 16) = \{0, \dots, 6\}</math> for i from <math>\{0, \dots, 159\}</math> together with the TDD UL-DL configuration specified in A2.3.</p>					

### A.3.3.3 FRC for receiver requirements for 16QAM

TBD

## A.3.3.4 FRC for receiver requirements for 64QAM

Table A.3.3.4-1: Fixed Reference Channel for Receiver Requirements (SCS 60 kHz, TDD)

Parameter	Unit	Value		
Channel bandwidth	MHz	50	100	200
Subcarrier spacing configuration $\mu$		2	2	2
Allocated resource blocks		66	132	264
Subcarriers per resource block		12	12	12
Allocated slots per Frame (NOTE 6)		23 / 24	23 / 24	23 / 24
MCS index		19	19	19
Modulation		64QAM	64QAM	64QAM
Target Coding Rate		1/2	1/2	1/2
Maximum number of HARQ transmissions		1	1	1
Information Bit Payload per Slot				
For Slots 0 and Slot i, if $\text{mod}(i, 5) = \{3,4\}$ for i from $\{0, \dots, 79\}$	Bits	N/A	N/A	N/A
For Slot i, if $\text{mod}(i, 10) = \{0,1,2\}$ for i from $\{1, \dots, 79\}$	Bits	20496	40976	81976
Transport block CRC	Bits	24	24	24
LDPC base graph		1	1	1
Number of Code Blocks per Slot				
For Slots 0 and Slot i, if $\text{mod}(i, 5) = \{3,4\}$ for i from $\{0, \dots, 79\}$	CBs	N/A	N/A	N/A
For Slot i, if $\text{mod}(i, 10) = \{0,1,2\}$ for i from $\{1, \dots, 79\}$	CBs	3	5	10
Binary Channel Bits Per Slot				
For Slots 0 and Slot i, if $\text{mod}(i, 5) = \{3,4\}$ for i from $\{0, \dots, 79\}$	Bits	N/A	N/A	N/A
For Slot i, if $\text{mod}(i, 5) = \{0,1,2\}$ for i from $\{1, \dots, 79\}$	Bits	40392	80784	161568
Max. Throughput averaged over 1 frame (NOTE 7)	Mbps	49.190	98.343	196.742
Note 1: Additional parameters are specified in Table A.3.1-1 and Table A.3.3.1-1.				
Note 2: If more than one Code Block is present, an additional CRC sequence of L = 24 Bits is attached to each Code Block (otherwise L = 0 Bit).				
Note 3: SS/PBCH block is transmitted in slot 0 with periodicity 20 ms				
Note 4: Slot i is slot index per 2 frames				
Note 5: PTRS is configured on symbols containing PDSCH with 1 port, per 2PRB in frequency domain, per symbol in time domain. Overhead for TBS calculation is assumed to be 6.				
NOTE 6: First number corresponds to the number slots allocated in the first frame of the RMC; second number corresponds to the number slots allocated in the second frame of the RMC.				
NOTE 7: Throughput is averaged over 2nd frame of RMC.				

Table A.3.3.4-2: Fixed Reference Channel for Receiver Requirements (SCS 120 kHz, TDD)

Parameter	Unit	Value			
Channel bandwidth	MHz	50	100	200	400
Subcarrier spacing configuration $\mu$		3	3	3	3
Allocated resource blocks		32	66	132	264
Subcarriers per resource block		12	12	12	12
Allocated slots per Frame (NOTE 6)		47 / 48	47 / 48	47 / 48	47 / 48
MCS index		19	19	19	19
Modulation		64QAM	64QAM	64QAM	64QAM
Target Coding Rate		1/2	1/2	1/2	1/2
Maximum number of HARQ transmissions		1	1	1	1
Information Bit Payload per Slot					
For Slots 0 and Slot i, if $\text{mod}(i, 5) = \{3,4\}$ for i from $\{0, \dots, 159\}$	Bits	N/A	N/A	N/A	N/A
For Slot i, if $\text{mod}(i, 5) = \{0,1,2\}$ for i from $\{1, \dots, 159\}$	Bits	9992	20496	40976	81976
Transport block CRC	Bits	24	24	24	24

LDPC base graph		1	1	1	1
Number of Code Blocks per Slot					
For Slots 0 and Slot i, if $\text{mod}(i, 5) = \{3,4\}$ for i from $\{0, \dots, 159\}$	CBs	N/A	N/A	N/A	N/A
For Slot i, if $\text{mod}(i, 5) = \{0,1,2\}$ for i from $\{1, \dots, 159\}$	CBs	2	3	5	10
Binary Channel Bits Per Slot					
For Slots 0 and Slot i, if $\text{mod}(i, 5) = \{3,4\}$ for i from $\{0, \dots, 159\}$	Bits	N/A	N/A	N/A	N/A
For Slot i, if $\text{mod}(i, 5) = \{0,1,2\}$ for i from $\{1, \dots, 159\}$	Bits	19584	40392	80784	161568
Max. Throughput averaged over 1 frame (NOTE 7)	Mbps	47.962	98.381	196.685	393.485
<p>Note 1: Additional parameters are specified in Table A.3.1-1 and Table A.3.3.1-1.</p> <p>Note 2: If more than one Code Block is present, an additional CRC sequence of L = 24 Bits is attached to each Code Block (otherwise L = 0 Bit).</p> <p>Note 3: SS/PBCH block is transmitted in slot with periodicity 20 ms</p> <p>Note 4: Slot i is slot index per 2 frames</p> <p>Note 5: PTRS is configured on symbols containing PDSCH with 1 port, per 2PRB in frequency domain, per symbol in time domain. Overhead for TBS calculation is assumed to be 6.</p> <p>NOTE 6: First number corresponds to the number slots allocated in the first frame of the RMC; second number corresponds to the number slots allocated in the second frame of the RMC.</p> <p>NOTE 7: Throughput is averaged over 2nd frame of RMC.</p>					

### A.3.3.5 FRC for receiver requirements for 256QAM

**Table A.3.3.5-1 Fixed Reference Channel for Receiver Requirements (SCS 60 kHz, TDD)**

Parameter	Unit	Value		
Channel bandwidth	MHz	50	100	200
Subcarrier spacing configuration $\mu$		2	2	2
Allocated resource blocks		66	132	264
Subcarriers per resource block		12	12	12
Allocated slots per Frame (NOTE 6)		23 / 24	23 / 24	23 / 24
MCS index		24	24	24
Modulation		256QAM	256QAM	256QAM
Target Coding Rate		4/5	4/5	4/5
Maximum number of HARQ transmissions		1	1	1
Information Bit Payload per Slot				
For Slots 0 and Slot i, if $\text{mod}(i, 5) = \{3,4\}$ for i from $\{0, \dots, 79\}$	Bits	N/A	N/A	N/A
For Slot i, if $\text{mod}(i, 5) = \{0,1,2\}$ for i from $\{1, \dots, 79\}$	Bits	44040	88064	176208
Transport block CRC	Bits	24	24	24
LDPC base graph		1	1	1
Number of Code Blocks per Slot				
For Slots 0 and Slot i, if $\text{mod}(i, 5) = \{3,4\}$ for i from $\{0, \dots, 79\}$	CBs	N/A	N/A	N/A
For Slot i, if $\text{mod}(i, 5) = \{0,1,2\}$ for i from $\{1, \dots, 79\}$	CBs	6	11	21
Binary Channel Bits Per Slot				
For Slots 0 and Slot i, if $\text{mod}(i, 5) = \{3,4\}$ for i from $\{0, \dots, 79\}$	Bits	N/A	N/A	N/A
For Slot i, if $\text{mod}(i, 5) = \{0,1,2\}$ for i from $\{1, \dots, 79\}$	Bits	53856	107712	215424
Max. Throughput averaged over 1 frame (NOTE 7)	Mbps	105.696	211.354	422.899
<p>NOTE 1: Additional parameters are specified in Table A.3.1-1 and Table A.3.3.1-1.</p> <p>NOTE 2: If more than one Code Block is present, an additional CRC sequence of L = 24 Bits is attached to each Code Block (otherwise L = 0 Bit).</p> <p>NOTE 3: SS/PBCH block is transmitted in slot 0 of each frame</p> <p>NOTE 4: Slot i is slot index per 2 frames</p> <p>NOTE 5: PTRS is configured on symbols containing PDSCH with 1 port, per 2PRB in frequency domain, per symbol in time domain. Overhead for TBS calculation is</p>				



assumed to be 6.  
 NOTE 6: First number corresponds to the number slots allocated in the first frame of the RMC; second number corresponds to the number slots allocated in the second frame of the RMC.  
 NOTE 7: Throughput is averaged over 2nd frame of RMC.

**Table A.3.3.5-2 Fixed Reference Channel for Receiver Requirements (SCS 120 kHz, TDD)**

Parameter	Unit	Value			
		50	100	200	400
Channel bandwidth	MHz	50	100	200	400
Subcarrier spacing configuration $\mu$		3	3	3	3
Allocated resource blocks		32	66	132	264
Subcarriers per resource block		12	12	12	12
Allocated slots per Frame (NOTE 6)		47 / 48	47 / 48	47 / 48	47 / 48
MCS index		24	24	24	24
Modulation		256QAM	256QAM	256QAM	256QAM
Target Coding Rate		4/5	4/5	4/5	4/5
Maximum number of HARQ transmissions		1	1	1	1
Information Bit Payload per Slot					
For Slots 0 and Slot i, if $\text{mod}(i, 5) = \{3,4\}$ for i from $\{0, \dots, 159\}$	Bits	N/A	N/A	N/A	N/A
For Slot i, if $\text{mod}(i, 5) = \{0,1,2\}$ for i from $\{1, \dots, 159\}$	Bits	21504	44040	88064	176208
Transport block CRC	Bits	24	24	24	24
LDPC base graph		1	1	1	1
Number of Code Blocks per Slot					
For Slots 0 and Slot i, if $\text{mod}(i, 5) = \{3,4\}$ for i from $\{0, \dots, 159\}$	CBs	N/A	N/A	N/A	N/A
For Slot i, if $\text{mod}(i, 5) = \{0,1,2\}$ for i from $\{1, \dots, 159\}$	CBs	3	6	11	21
Binary Channel Bits Per Slot					
For Slots 0 and Slot i, if $\text{mod}(i, 5) = \{3,4\}$ for i from $\{0, \dots, 159\}$	Bits	N/A	N/A	N/A	N/A
For Slot i, if $\text{mod}(i, 5) = \{0,1,2\}$ for i from $\{1, \dots, 159\}$	Bits	26112	53856	107712	215424
Max. Throughput averaged over 1 frame (NOTE 7)	Mbps	103.219	211.392	422.707	845.798
NOTE 1: Additional parameters are specified in Table A.3.1-1 and Table A.3.3.1-1. NOTE 2: If more than one Code Block is present, an additional CRC sequence of L = 24 Bits is attached to each Code Block (otherwise L = 0 Bit). NOTE 3: SS/PBCH block is transmitted in slot 0 of each frame NOTE 4: Slot i is slot index per 2 frames NOTE 5: PTRS is configured on symbols containing PDSCH with 1 port, per 2PRB in frequency domain, per symbol in time domain. Overhead for TBS calculation is assumed to be 6. NOTE 6: First number corresponds to the number slots allocated in the first frame of the RMC; second number corresponds to the number slots allocated in the second frame of the RMC. NOTE 7: Throughput is averaged over 2nd frame of RMC.					

## A.4 Void

## A.5 OFDMA Channel Noise Generator (OCNG)

### A.5.1 OCNG Patterns for FDD

TBD

## A.5.2 OCNG Patterns for TDD

### A.5.2.1 OCNG TDD pattern 1: Generic OCNG TDD Pattern for all unused REs

**Table A.5.2.1-1: OP.1 TDD: Generic OCNG TDD Pattern for all unused REs**

<b>OCNG Distribution</b>	<b>Control Region (Core Set)</b>	<b>Data Region</b>
<b>OCNG Parameters</b>		
Resources allocated	All unused REs (Note 1)	All unused REs (Note 2)
Structure	PDCCH	PDSCH
Content	Uncorrelated pseudo random QPSK modulated data	Uncorrelated pseudo random QPSK modulated data
Transmission scheme for multiple antennas ports transmission	Single Tx port transmission	Spatial multiplexing using any precoding matrix with dimensions same as the precoding matrix for PDSCH
Subcarrier Spacing	Same as for RMC PDCCH in the active BWP	Same as for RMC PDSCH in the active BWP
Power Level	Same as for RMC PDCCH	Same as for RMC PDSCH
Note 1:	All unused REs in the active CORESETS appointed by the search spaces in use.	
Note 2:	Unused available REs refer to REs in PRBs not allocated for any physical channels, CORESETs, synchronization signals or reference signals in channel bandwidth.	

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## Annex B (normative): Propagation conditions

### B.0 No interference

The downlink connection between the System Simulator and the UE is without Additive White Gaussian Noise, and has no fading or multipath effects.

## Annex C (normative): Downlink Physical Channels

### C.0 Downlink signal levels

**Editor's Note :** Consideration to minimize the required number of additional FR2 link is under discussion

The downlink power settings in Table C.0-1 is used unless otherwise specified in a test case.

**Table C.0-1: Default Downlink power levels for NR**

SCS (kHz)		Unit	Channel Bandwidth			
			50 MHz	100 MHz	200 MHz	400 MHz
60	Number of RBs		66	132	264	N/A
	Channel BW power	dBm	-70	-67	-64	N/A
120	Number of RBs		32	66	132	264
	Channel BW power	dBm	-70	-67	-64	-61
	SS/PBCH SSS EPRE	dBm/SCS	-99 for DL SCS= 60 kHz -96 for DL SCS = 120 kHz	-99 for DL SCS = 60 kHz -96 for DL SCS = 120 kHz	-99 for DL SCS = 60 kHz -96 for DL SCS = 120 kHz	-99 for DL SCS = 60 kHz -96 for DL SCS = 120 kHz
<p>Note 1: The channel bandwidth powers are informative, based on [-99]dBm/60kHz SS/PBCH SSS EPRE, then scaled according to the number of RBs and rounded to the nearest integer dBm value. Full RE allocation with no boost or deboost is assumed.</p> <p>Note 2: The power level is specified at the centre of quiet zone.</p> <p>Note 3: DL level is applied for any of the Subcarrier Spacing configuration (<math>\mu</math>) with the same power spectrum density of [-99]dBm/60kHz.</p>						

The default downlink signal level uncertainty is +/- TBD dB, for any level specified. If the uncertainty value is critical for the test purpose, a tighter uncertainty is specified for the related test case in Annex F.

For TRP measurement, DL signal may be supplied from RSRP based pathloss compensation link. Downlink signal level using RSRP based pathloss compensation link is specified in Table C.0-2 or Table C.0-3.

**Table C.0-2: Downlink power levels for RSRP based pathloss compensation link for TRP measurement for n257, n258 and n260**

SCS (kHz)		Unit	Channel Bandwidth			
			50 MHz	100 MHz	200 MHz	400 MHz
60	Number of RBs		66	132	264	N/A
	Channel BW power	dBm	$\geq -87$	$\geq -84$	$\geq -80$	N/A
120	Number of RBs		32	66	132	264
	Channel BW power	dBm	$\geq -87$	$\geq -84$	$\geq -80$	$\geq -77$
	SS/PBCH SSS EPRE	dBm/SCS	$\geq -115.5$ for DL SCS = 60 kHz $\geq -112.5$ for DL SCS = 120 kHz	$\geq -115.5$ for DL SCS = 60 kHz $\geq -112.5$ for DL SCS = 120 kHz	$\geq -115.5$ for DL SCS = 60 kHz $\geq -112.5$ for DL SCS = 120 kHz	$\geq -115.5$ for DL SCS = 60 kHz $\geq -112.5$ for DL SCS = 120 kHz
<p>Note 1: The channel bandwidth powers are informative, based on -115.5dBm/60kHz SS/PBCH SSS EPRE, then scaled according to the number of RBs and rounded to the nearest integer dBm value. Full RE allocation with no boost or deboost is assumed.</p> <p>Note 2: The power level is specified at the RSRP reference point as defined in TS 38.215 [24].</p> <p>Note 3: DL level is applied for any of the Subcarrier Spacing configuration (<math>\mu</math>) with the same power spectrum density of <math>\geq -115.5</math> dBm/60kHz.</p>						

**Table C.0-3: Downlink power levels for RSRP based pathloss compensation link for TRP measurement for n261**

SCS (kHz)		Unit	Channel Bandwidth			
			50 MHz	100 MHz	200 MHz	400 MHz
60	Number of RBs		66	132	264	N/A
	Channel BW power	dBm	≥ -84	≥ -81	≥ -78	N/A
120	Number of RBs		32	66	132	264
	Channel BW power	dBm	≥ -84	≥ -81	≥ -78	≥ -75
	SS/PBCH SSS EPRE	dBm/SCS	≥ -113 for DL SCS = 60 kHz ≥ -110 for DL SCS = 120 kHz	≥ -113 for DL SCS = 60 kHz ≥ -110 for DL SCS = 120 kHz	≥ -113 for DL SCS = 60 kHz ≥ -110 for DL SCS = 120 kHz	≥ -113 for DL SCS = 60 kHz ≥ -110 for DL SCS = 120 kHz

Note 1: The channel bandwidth powers are informative, based on -113dBm/60kHz SS/PBCH SSS EPRE, then scaled according to the number of RBs and rounded to the nearest integer dBm value. Full RE allocation with no boost or deboost is assumed.

Note 2: The power level is specified at the RSRP reference point as defined in TS 38.215 [24].

Note 3: DL level is applied for any of the Subcarrier Spacing configuration ( $\mu$ ) with the same power spectrum density of  $\geq -113$  dBm/60kHz.

## C.1 General

The following clauses describes the downlink Physical Channels that are transmitted during a connection i.e., when measurements are done.

## C.2 Setup

Table C.2-1 describes the downlink Physical Channels that are required for connection set up.

**Table C.2-1: Downlink Physical Channels required for connection set-up**

Physical Channel
PBCH
SSS
PSS
PDCCH
PDSCH
PBCH DMRS
PDCCH DMRS
PDSCH DMRS
CSI-RS
PTRS

As common PDSCH and PDCCH configuration parameters the parameters in Table A.3.1-1, C.2-2, C.2-3, and C.2-4 shall be used to bring up the connection setup for FR1 NR cell.

**Table C.2-2: PDSCH and PDCCH configuration**

Parameter	Unit	Value
Number of HARQ processes		8 (TDD)
Aggregation level	CCE	4

**Table C.2-3: Additional test parameters for TDD for SCS 60 KHz**

Parameter	Unit	UL-DL pattern
-----------	------	---------------

TDD Slot Configuration pattern (Note 1)			DDSU
Special Slot Configuration (Note 2)			11D+3G+0U
UL-DL configuration ( <i>tdd-UL-DL-ConfigurationCommon</i> )	<i>referenceSubcarrierSpacing</i>	kHz	60
	<i>dl-UL-TransmissionPeriodicity</i>	ms	1
	<i>nrofDownlinkSlots</i>		2
	<i>nrofDownlinkSymbols</i>		11
	<i>nrofUplinkSlot</i>		1
	<i>nrofUplinkSymbols</i>		0
K1 value (PDSCH-to-HARQ-timing-indicator)			K1 = 3 if mod(i,4) = 0 K1 = 2 if mod(i,4) = 1 K1 = 5 if mod(i,4) = 2
Note 1: D denotes a slot with all DL symbols; S denotes a slot with a mix of DL, UL and guard symbols; U denotes a slot with all UL symbols. The field is for information.			
Note 2: D, G, U denote DL, guard and UL symbols, respectively. The field is for information.			
Note 3: i is the slot index per frame; i = {0,...,39}			

Table C.2-4: Additional test parameters for TDD for SCS 120 KHz

Parameter		Unit	UL-DL pattern
TDD Slot Configuration pattern (Note 1)			DDDSU
Special Slot Configuration (Note 2)			10D+2G+2U
UL-DL configuration ( <i>tdd-UL-DL-ConfigurationCommon</i> )	<i>referenceSubcarrierSpacing</i>	kHz	120
	<i>dl-UL-TransmissionPeriodicity</i>	ms	0.625
	<i>nrofDownlinkSlots</i>		3
	<i>nrofDownlinkSymbols</i>		10
	<i>nrofUplinkSlot</i>		1
	<i>nrofUplinkSymbols</i>		2
K1 value (PDSCH-to-HARQ-timing-indicator)			K1 = [4] if mod(i,5) = 0 K1 = [3] if mod(i,5) = 1 K1 = [2] if mod(i,5) = 2 K1 = [6] if mod(i,5) = 3
Note 1: D denotes a slot with all DL symbols; S denotes a slot with a mix of DL, UL and guard symbols; U denotes a slot with all UL symbols. The field is for information.			
Note 2: D, G, U denote DL, guard and UL symbols, respectively. The field is for information.			
Note 3: i is the slot index per frame; i = {0,...,79}			

## C.3 Connection

### C.3.0 Measurement of Transmitter Characteristics

Unless otherwise stated, Table C.3.0-1 is applicable for measurements on the Transmitter Characteristics (clause 6).

Table C.3.0-1: Downlink Physical Channels transmitted during a connection (TDD)

Parameter	Unit	Value
SSS transmit power	W	Test specific
EPRE ratio of PSS to SSS	dB	0
EPRE ratio of PBCH to SSS	dB	0
EPRE ratio of PBCH to PBCH DMRS	dB	0
EPRE ratio of PDCCH to SSS	dB	0
EPRE ratio of PDCCH to PDCCH DMRS	dB	0
EPRE ratio of PDSCH to SSS	dB	0
EPRE ratio of PDSCH to PDSCH DMRS (Note 1)	dB	-3
EPRE ratio of CSI-RS to SSS	dB	0
EPRE ratio of PTRS to PDSCH	dB	Test specific
EPRE ratio of OCNG DMRS to SSS	dB	0
EPRE ratio of OCNG to OCNG DMRS (Note 1)	dB	0
Note 1: No boosting is applied to any of the channels except PDSCH DMRS. For PDSCH DMRS, 3 dB power boosting is applied assuming DMRS Type 1 configuration when DMRS and PDSCH are TDM'ed and only half of the DMRS REs are occupied.		

Note 2: Number of DMRS CDM groups without data for PDSCH DMRS configuration for OCNG is set to 1.
---

### C.3.1 Measurement of Receiver Characteristics

Unless otherwise stated, Table C.3.1-1 is applicable for measurements on the Receiver Characteristics (clause 7). For Adjacent channel selectivity testing, Table C.3.1-2 is applied.

**Table C.3.1-1: Downlink Physical Channels transmitted during a connection (TDD)**

Parameter	Unit	Value
SSS transmit power	W	Test specific
EPRE ratio of PSS to SSS	dB	0
EPRE ratio of PBCH to SSS	dB	0
EPRE ratio of PBCH to PBCH DMRS	dB	0
EPRE ratio of PDCCH to SSS	dB	0
EPRE ratio of PDCCH to PDCCH DMRS	dB	0
EPRE ratio of PDSCH to SSS	dB	0
EPRE ratio of PDSCH to PDSCH DMRS (Note 1)	dB	-3
EPRE ratio of CSI-RS to SSS	dB	0
EPRE ratio of PTRS to PDSCH	dB	Test specific
EPRE ratio of OCNG DMRS to SSS	dB	0
EPRE ratio of OCNG to OCNG DMRS (Note 1)	dB	0
Note 1: No boosting is applied to any of the channels except PDSCH DMRS. For PDSCH DMRS, 3 dB power boosting is applied assuming DMRS Type 1 configuration when DMRS and PDSCH are TDM'ed and only half of the DMRS REs are occupied.		
Note 2: Number of DMRS CDM groups without data for PDSCH DMRS configuration for OCNG is set to 1.		

**Table C.3.1-2: PDCCH Aggregation Level for ACS testing**

Parameter	Unit	Value	Comment
Aggregation level	CCE	4	CBW=50MHz when SCS=120kHz
		8	CBW=50MHz when SCS=60kHz CBW=100MHz when SCS=120kHz
		16	CBW>100 MHz when SCS=60kHz CBW>100 MHz when SCS=120kHz

---

## Annex D (normative): Characteristics of the interfering signal

### D.1 General

Unless otherwise stated, a modulated full bandwidth NR downlink signal, which equals to channel bandwidth of the wanted signal for Single Carrier case is used as interfering signals when RF performance requirements for NR UE receiver are defined. For intra-band contiguous CA case, a modulated NR downlink signal which equals to the aggregated channel bandwidth of the wanted signal is used.

---

### D.2 Interference signals

Table D.2-1 describes the modulated interferer for different channel bandwidth options.

**Table D.2-1: Description of modulated NR interferer**

	Channel bandwidth for Single Carrier				Intra band contiguous CA
	50 MHz	100 MHz	200 MHz	400 MHz	
BW <sub>interferer</sub>	50 MHz	100 MHz	200 MHz	400MHz	BW <sub>Channel_CA</sub>
RB	NOTE1				
NOTE 1: The RB configured for interfering signal is the same as maximum RB number defined in Table 5.3.2-1 for each sub-carrier spacing.					



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## Annex E (normative): Global In-Channel TX-Test

NOTE: Clauses E.2.2 to E.5.9.3 are descriptions, which assume no power ramping adjacent to the measurement period.

---

### E.1 General

The global in-channel TX test enables the measurement of all relevant parameters that describe the in-channel quality of the output signal of the TX under test in a single measurement process.

The parameters describing the in-channel quality of a transmitter, however, are not necessarily independent. The algorithm chosen for description inside this annex places particular emphasis on the exclusion of all interdependencies among the parameters.

---

### E.2 Signals and results

#### E.2.1 Basic principle

The process is based on the comparison of the actual **output signal of the TX under test**, received by an ideal receiver, with a **reference signal**, that is generated by the measuring equipment and represents an ideal error free received signal. All signals are represented as equivalent (generally complex) baseband signals.

The description below uses numbers as examples. These numbers are taken from TDD with normal CP length and 100 MHz bandwidth with 60 kHz SCS. The application of the text below, however, is not restricted to this frame structure and bandwidth.

#### E.2.2 Output signal of the TX under test

The output signal of the TX under test is acquired by the measuring equipment and stored for further processing. It is sampled at a sampling rate of 122.88 Mbps. In the time domain it comprises at least 10 uplink subframes. The measurement period is derived by concatenating the correct number of individual uplink slots until the correct measurement period is reached. The output signal is named  $z(v)$ . Each slot is modelled as a signal with the following parameters: demodulated data content, carrier frequency, amplitude and phase for each subcarrier, timing, carrier leakage.

NOTE 1: TDD

Since the uplink subframes are not continuous, the  $n$  slots should be extracted from more than 1 continuous radio frame where

$$n = \begin{cases} 40, & \text{for 60 kHz SCS} \\ 80, & \text{for 120 kHz SCS} \end{cases}$$

#### E.2.3 Reference signal

Two types of reference signal are defined:

The reference signal  $i_1(v)$  is constructed by the measuring equipment according to the relevant TX specifications, using the following parameters: demodulated data content, nominal carrier frequency, nominal amplitude and phase for each

subcarrier, nominal timing, no carrier leakage. It is represented as a sequence of samples at a sampling rate of 122.88 Mbps in the time domain.

The reference signal  $i_2(v)$  is constructed by the measuring equipment according to the relevant TX specifications, using the following parameters: restricted data content: nominal reference symbols, (all modulation symbols for user data symbols are set to 0V), nominal carrier frequency, nominal amplitude and phase for each applicable subcarrier, nominal timing, no carrier leakage. It is represented as a sequence of samples at a sampling rate of 122.88 Mbps in the time domain.

NOTE: The PUCCH is off during the time under test.

## E.2.4 Measurement results

The measurement results, achieved by the global in channel TX test are the following:

- Carrier Frequency error
- EVM (Error Vector Magnitude)
- Carrier leakage
- Unwanted emissions, falling into non allocated resource blocks.
- EVM equalizer spectrum flatness

## E.2.5 Measurement points

The unwanted emission falling into non-allocated RB(s) is calculated directly after the FFT as described below. In contrast to this, the EVM for the allocated RB(s) is calculated after the IDFT for DFT-s-OFDM or after the Tx-Rx chain equalizer for CP-OFDM. The samples after the TX-RX chain equalizer are used to calculate EVM equalizer spectrum flatness. Carrier frequency error and carrier leakage is calculated in the block “RF correction”.

In case the parameter 3300 or 3301 is reported from UE via *txDirectCurrentLocation* IE (as defined in TS 38.331 [6]), carrier leakage measurement in the RF correction block shall be omitted. All statements from Annex E.3 onwards shall be read assuming that no carrier leakage has been measured.

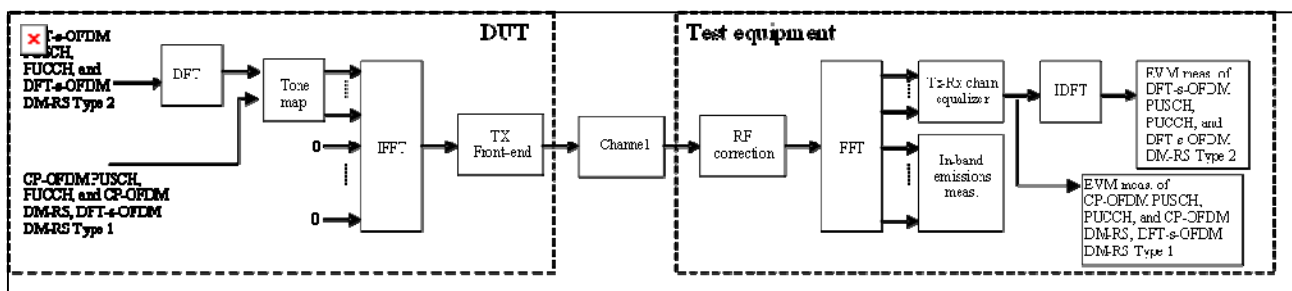


Figure E.2.5-1: EVM measurement points

## E.3 Signal processing

### E.3.1 Pre FFT minimization process

Before applying the pre-FFT minimization process,  $z(v)$  and  $i(v)$  are partitioned into  $n$  pieces, comprising one slot each, where  $n$  is as defined in Annex E.2.2.

Each slot is processed separately. Sample timing, Carrier frequency and carrier leakage in  $z(v)$  are jointly varied in order to minimise the difference between  $z(v)$  and  $i(v)$ . Best fit (minimum difference) is achieved when the RMS difference value between  $z(v)$  and  $i(v)$  is an absolute minimum.

The carrier frequency variation and the IQ variation are the measurement results: Carrier Frequency Error and Carrier leakage.

From the acquired samples 10 carrier frequencies can be derived by averaging frequency errors for every 4 or 8 slots for 60 and 120 kHz SCS.

From the acquired samples  $n$  carrier frequencies and  $n$  carrier leakages can be derived.

NOTE 1: The minimisation process, to derive carrier leakage and RF error can be supported by Post FFT operations. However the minimisation process defined in the pre FFT domain comprises all acquired samples (i.e. it does not exclude the samples in between the FFT widths and it does not exclude the bandwidth outside the transmission bandwidth configuration)

NOTE 2: The algorithm would allow deriving Carrier Frequency error and Sample Frequency error of the TX under test separately. However there are no requirements for Sample Frequency error. Hence the algorithm models the RF and the sample frequency commonly (not independently). It returns one error and does not distinguish between both.

After this process the samples  $z(v)$  are called  $z^0(v)$ .

## E.3.2 Timing of the FFT window

The FFT window length is 2048 samples per OFDM symbol. 14 FFTs (28672 samples) cover less than the acquired number of samples (30720 samples). The position in time for FFT must be determined.

In an ideal signal, the FFT may start at any instant within the cyclic prefix without causing an error. The TX filter, however, reduces the window. The EVM requirements shall be met within a window  $W < CP$ . There are three different instants for FFT:

Centre of the reduced window, called  $\Delta\tilde{c}$ ,  $\Delta\tilde{c} - W/2$  and  $\Delta\tilde{c} + W/2$ .

The timing of the measured signal is determined in the pre FFT domain as follows, using  $z^0(v)$  and  $i_2(v)$  :

1. The measured signal is delay spread by the TX filter. Hence the distinct borders between the OFDM symbols and between Data and CP are also spread and the timing is not obvious.
2. In the Reference Signal  $i_2(v)$  the timing is known.
3. Correlation between (1.) and (2.) will result in a correlation peak. The meaning of the correlation peak is approx. the "impulse response" of the TX filter. The meaning of "impulse response" assumes that the autocorrelation of the reference signal  $i_2(v)$  is a Dirac peak and that the correlation between the reference signal  $i_2(v)$  and the data in the measured signal is 0. The correlation peak, (the highest, or in case of more than one, the earliest) indicates the timing in the measured signal.

From the acquired samples,  $n$  timings can be derived.

For all calculations, except EVM, the number of samples in  $z^0(v)$  is reduced to 14 blocks of samples, comprising 2048 samples (FFT width) and starting with  $\Delta\tilde{c}$  in each OFDM symbol including the demodulation reference signal.

For the EVM calculation the output signal under test is reduced to 28 blocks of samples, comprising 2048 samples (FFT width) and starting with  $\Delta\tilde{c} - W/2$  and  $\Delta\tilde{c} + W/2$  in each OFDM symbol including the demodulation reference signal.

The number of samples, used for FFT is reduced compared to  $z^0(v)$ . This subset of samples is called  $z'(v)$ .

The timing of the centre  $\Delta\tilde{c}$  with respect to the different CP length in a slot is as follows: (TDD, normal CP length)

$\Delta\tilde{c}$  is on  $T_f=72$  (=CP/2) within the CP of length 144 FFT samples (in OFDM symbols except 0 and 28 (=7 \* 2<sup>#</sup>), where symbol 0 is the first symbol of each subframe) for channel bandwidth of 100 MHz and SCS = 60 kHz.

$\Delta\tilde{c}$  is on  $T_f=136$  ( $=208-72$ ) within the CP of length 208 FFT samples (in OFDM symbol 0 and 28 ( $=7 \cdot 2^4$ ), where symbol 0 is the first symbol of each subframe) for channel bandwidth of 100 MHz and SCS = 60 kHz.

### E.3.3 Post FFT equalisation

Perform 14 FFTs on  $z'(v)$ , one for each OFDM symbol in a slot using the timing  $\Delta\tilde{c}$ , including the demodulation reference symbol. The result is an array of samples, 14 in the time axis  $t$  times 2048 in the frequency axis  $f$ . The samples represent the data symbols (in OFDM-symbol 0,1,3,4,5,6,8,9,10,12,13 in each slot) and demodulation reference symbols (OFDM symbol 2, 7, 11 in each slot) in the allocated RBs and inband emissions in the non allocated RBs within the transmission BW.

Only the allocated resource blocks in the frequency domain are used for equalisation.

The nominal demodulation reference symbols and nominal data symbols are used to equalize the measured data symbols. (Location for equalization see Figure E.2.5-1)

NOTE: The nomenclature inside this note is local and not valid outside.

The nominal data symbols are created by a demodulation process. The location to gain the demodulated data symbols is "EVM" in Figure E.2.5-1. For CP-OFDM, the process described in Annex E.5 can be applied. A demodulation process as follows is recommended for DFT-s-OFDM:

1. Equalize the measured data symbols using the reference symbols for equalisation. Result: Equalized data symbols
2. Only for DFT-s-OFDM, iDFT transform the equalized data symbols: Result: Equalized data symbols
3. Decide for the nearest constellation point: Result: Nominal data symbols
4. Only for DFT-s-OFDM, DFT transform the nominal data symbols: Result: Nominal data symbols

At this stage we have an array of Measured data-Symbols and reference-Symbols ( $MS(f,t)$ )

versus an array of Nominal data-Symbols and reference Symbols ( $NS(f,t)$ )

(complex, the arrays comprise 11 data symbols and 3 demodulation reference symbol in the time axis and the number of allocated subcarriers in the frequency axis.)

$MS(f,t)$  and  $NS(f,t)$  are processed with a least square (LS) estimator, to derive one equalizer coefficient per time slot and per allocated subcarrier.  $EC(f)$  is defined as

$$EC(f) = \frac{\sum_{t=0}^{13} NS(f, t) * NS(f, t)}{\sum_{t=0}^{13} NS(f, t) * MS(f, t)}$$

With  $*$  denoting complex conjugation.

$EC(f)$  are used to equalize the DFT-coded data symbols. The measured DFT-coded data and the references symbols are equalized by:

$$Z'(f,t) = MS(f,t) \cdot EC(f)$$

With  $\cdot$  denoting multiplication.

$Z'(f,t)$ , restricted to the data symbol (excluding  $t=2,7,11$ ) is used to calculate EVM, as described in E.4.1.

$EC(f)$  is used in E.4.4 to calculate EVM equalizer spectral flatness.

NOTE: The post FFT minimisation process is done over 14 symbols (11 DFT-coded data symbols and 3 reference symbols).

The samples of the non allocated resource blocks within the transmission bandwidth configuration in the post FFT domain are called  $Y(f,t)$  ( $f$  covering the non allocated subcarriers within the transmission bandwidth configuration,  $t$  covering the OFDM symbols during 1 slot).

## E.4 Derivation of the results

### E.4.1 EVM

For EVM create two sets of  $Z'(f,t)$ , according to the timing " $\Delta\tilde{c} - W/2$  and  $\Delta\tilde{c} + W/2$ " using the equalizer coefficients from E.3.3.

Perform the iDFTs on  $Z'(f,t)$  in the case of DFT-s-OFDM waveform. The IDFT-decoding preserves the meaning of  $t$  but transforms the variable  $f$  (representing the allocated sub carriers) into another variable  $g$ , covering the same count and representing the demodulated symbols. The samples in the post IDFT domain are called  $iZ'(g, t)$ . The equivalent ideal samples are called  $iI(g,t)$ . Those samples of  $Z'(f,t)$ , carrying the reference symbols (=symbol 2,7,11) are not iDFT processed.

The EVM is the difference between the ideal waveform and the measured and equalized waveform for the allocated RB(s)

$$EVM = \sqrt{\frac{\sum_{t \in T} \sum_{g \in G} |iZ'(g, t) - iI(g, t)|^2}{|G| \cdot |T| \cdot P_0}}$$

where

$t$  covers the count of demodulated symbols with the considered modulation scheme being active within the measurement period, (i.e. symbol 0,1,3,4,5,6,8,9,10,12,13 in each slot,  $\rightarrow |T|=11$ )

$g$  covers the count of demodulated symbols with the considered modulation scheme being active within the allocated bandwidth. ( $|G|=12 * L_{CRBs}$  (with  $L_{CRBs}$  : number of allocated resource blocks)).

$iZ'(g, t)$  are the samples of the signal evaluated for the EVM.

$iI(g, t)$  is the ideal signal reconstructed by the measurement equipment, and

$P_0$  is the average power of the ideal signal. For normalized modulation symbols  $P_0$  is equal to 1.

From the acquired samples  $2n$  EVM values can be derived,  $n$  values for the timing  $\Delta\tilde{c} - W/2$  and  $n$  values for the timing  $\Delta\tilde{c} + W/2$

### E.4.2 Averaged EVM

EVM is averaged over all basic EVM measurements.

The averaging comprises  $n$  UL slots

$$\overline{EVM} = \sqrt{\frac{1}{n} \sum_{i=1}^n EVM_i^2}$$

where



for PUCCH, PUSCH.

The averaging is done separately for timing  $\Delta\tilde{c} - W/2$  and  $\Delta\tilde{c} + W/2$  leading to  $\overline{EVM}_l$  and  $\overline{EVM}_h$

$EVM_{\text{final}} = \max(\overline{EVM}_1, \overline{EVM}_h)$  is compared against the test requirements.

### E.4.3 In-band emissions measurement

The in-band emissions are a measure of the interference falling into the non-allocated resources blocks.

Explanatory Note:

The inband emission measurement is only meaningful with allocated RB(s) next to non-allocated RB. The allocated RB(s) are necessary but not under test. The non allocated RBs are under test. The RB allocation for this test is as follows: The allocated RB(s) are at one end of the channel BW, leaving the other end unallocated. The number of allocated RB(s) is smaller than half of the number of RBs, available in the channel BW. This means that the vicinity of the carrier in the centre is unallocated.

There are 3 types of inband emissions:

1. General
2. IQ image
3. Carrier leakage

*Carrier leakage* are inband emissions next to the carrier.

*IQ image* are inband emissions symmetrically (with respect to the carrier) on the other side of the allocated RBs.

*General* are applied to all unallocated RBs.

For each evaluated RB, the minimum requirement is calculated as the higher of  $P_{RB} - 30$  dB and the power sum of all limit values (General, IQ Image or Carrier leakage) that apply.

In specific the following combinations:

- Power (General)
- Power (General + Carrier leakage)
- Power (General + IQ Image)

1 and 2 is expressed in terms of power in one non allocated RB under test, normalized to the average power of an allocated RB (unit dB).

3 is expressed in terms of power in one non allocated RB, normalized to the power of all allocated RBs. (unit dBc).

This is the reason for two formulas *Emissions relative*.

Create one set of  $Y(t,f)$  per slot according to the timing “ $\Delta\tilde{c}$ ”

For the non-allocated RBs below the in-band emissions are calculated as follows

$$Emissions_{\text{absolute}}(\Delta_{RB}) = \begin{cases} \frac{1}{|T_s|} \sum_{t \in T_s} \sum_{c_l + (12 \cdot \Delta_{RB} + 1) \cdot \Delta f}^{c_l + (12 \cdot \Delta_{RB} + 11) \cdot \Delta f} |Y(t, f)|^2, \Delta_{RB} < 0 \\ \frac{1}{|T_s|} \sum_{t \in T_s} \sum_{c_h + (12 \cdot \Delta_{RB} - 11) \cdot \Delta f}^{\min(f_{\max}, (c_h + 12 \cdot \Delta_{RB}) \cdot \Delta f)} |Y(t, f)|^2, \Delta_{RB} > 0 \end{cases}$$

where

the upper formula represents the in band emissions below the allocated frequency block and the lower one the in band emissions above the allocated frequency block.

$T_s$  is a set of  $|T_s|$  DFT-s-OFDM symbols with the considered modulation scheme being active within the measurement period,

$\Delta_{RB}$  is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g.  $\Delta_{RB} = 1$  for the first upper or  $\Delta_{RB} = -1$  for the first lower adjacent RB),

$f_{\min}$  and  $f_{\max}$  are the lower and upper edge of the UL transmission BW configuration,

$c_l$  and  $c_h$  are the lower and upper edge of the allocated BW,

$\Delta f$  is the SCS, and

$Y(t, f)$  is the frequency domain signal evaluated for in-band emissions as defined in clause E.3.3

The allocated RB power per RB and the total allocated RB power are given by:

$$P_{RB} = \frac{1}{|T_s| \cdot L_{CRBs}} \sum_{t \in T_s} \sum_{c_1}^{c_1 + (12 \cdot L_{CRBs} - 1) \cdot \Delta f} |\text{MS}(t, f)|^2 [\text{dBm}/(12\Delta f)]$$

$$P_{All-RBs} = \frac{1}{|T_s|} \sum_{t \in T_s} \sum_{c_1}^{c_1 + (12 \cdot L_{CRBs} - 1) \cdot \Delta f} |\text{MS}(t, f)|^2 [\text{dBm}]$$

The relative in-band emissions, applicable for General and IQ image, are given by:

$$\begin{aligned} Emissions_{relative}(\Delta_{RB}) &= 10 \cdot \log_{10} \left( \frac{Emissions_{absolute}(\Delta_{RB})}{\frac{1}{|T_s| \cdot L_{CRBs}} \sum_{t \in T_s} \sum_{c_l}^{c_l + (12 \cdot L_{CRBs} - 1) \cdot \Delta f} |\text{MS}(t, f)|^2} \right) [\text{dB}] = \\ &= Emissions_{absolute}(\Delta_{RB}) [\text{dBm}/12\Delta f] - P_{RB} [\text{dBm}/12\Delta f] \end{aligned}$$

where

$L_{CRBs}$  is the number of allocated resource blocks,

and

$\text{MS}(t, f)$  is the frequency domain samples for the allocated bandwidth, as defined in clause E.3.3.

The relative in-band emissions, applicable for carrier leakage, is given by:

$$\begin{aligned} Emissions_{relative} &= 10 \cdot \log_{10} \left( \frac{Emissions_{absolute}(RBnextDC)}{\frac{1}{|T_s|} \sum_{t \in T_s} \sum_{c_l}^{c_l + (12 \cdot L_{CRBs} - 1) \cdot \Delta f} |\text{MS}(t, f)|^2} \right) [\text{dBc}] \\ &= Emissions_{absolute}(RBnextDC) [\text{dBm}/12\Delta f] - P_{All-RBs} [\text{dBm}] \end{aligned}$$

where RBnextDC means: Resource Block next to the carrier.

This can be one RB or one pair of RBs, depending whether the DC carrier is inside an RB or in-between two RBs.

Although an exclusion period may be applicable in the time domain, when evaluating EVM, the inband emissions measurement interval is defined over one complete slot in the time domain.

From the acquired samples  $n$  functions for general in band emissions and IQ image inband emissions can be derived.  $n$  values or  $n$  pairs of carrier leakage inband emissions can be derived. They are compared against different limits.

The in-band emissions are averaged over the  $n$  samples (equivalent to 10 UL subframes):

$$\overline{Emissions}_{absolute}(\Delta_{RB}) = \frac{1}{n} \sum_{i=1}^n Emissions_{absolute,i}(\Delta_{RB})$$

$$\overline{Emissions}_{relative}(\Delta_{RB}) = 10 * \log_{10} \left( \frac{1}{n} \sum_{i=1}^n 10^{Emissions_{relative,i}(\Delta_{RB})/10} \right) [dB]$$

$$\overline{Emissions}_{relative} = 10 * \log_{10} \left( \frac{1}{n} \sum_{i=1}^n 10^{Emissions_{relative,i}/10} \right) [dBc]$$

#### E.4.4 EVM equalizer spectrum flatness

For EVM equalizer spectrum flatness use  $EC(f)$  as defined in E.3.3. Note,  $EC(f)$  represents equalizer coefficient  $f \in F$ ,  $f$  is the allocated subcarriers within the transmission bandwidth ( $|F|=12 * L_{CRBs}$ )

From the acquired samples  $n$  functions  $EC(f)$  can be derived.

$EC(f)$  is broken down to 2 functions:

$$EC_1(f), f \in Range\ 1$$

$$EC_2(f), f \in Range\ 2$$

Where Range 1 and Range 2 are as defined in Table 6.5.2.4.5-1 for normal condition and Table 6.5.2.4.5-2 for extreme condition

The following peak to peak ripple is calculated:

$$RP_1 = 20 * \log(\max(|EC_1(f)|) / \min(|EC_1(f)|)) , \text{ which denote the maximum ripple in Range 1}$$

$$RP_2 = 20 * \log(\max(|EC_2(f)|) / \min(|EC_2(f)|)) , \text{ which denote the maximum ripple in Range 2}$$

$RP_{12} = 20 * \log(\max(|EC_1(f)|) / \min(|EC_2(f)|))$ , which denote the maximum ripple between the upper side of Range 1 and lower side of Range 2

$RP_{21} = 20 * \log(\max(|EC_2(f)|) / \min(|EC_1(f)|))$  , which denote the maximum ripple between the upper side of Range 2 and lower side of Range 1

#### E.4.5 Frequency error and Carrier leakage

See E.3.1.



### E.4.6 EVM of Demodulation reference symbols (EVM<sub>DMRS</sub>)

For the purpose of EVM<sub>DMRS</sub>, the steps E.2.2 to E.4.2 are repeated 6 times, constituting 6 EVM<sub>DMRS</sub> sub-periods. The only purpose of the repetition is to cover the longer gross measurement period of EVM<sub>DMRS</sub> (6 · n time slots) and to derive the FFT window timing per sub-period.

The bigger of the EVM results in one n TS period corresponding to the timing! Δc̃ -W/2 or Δc̃ +W/2 is compared against the limit. (Clause E.4.2) This timing is re-used for EVM<sub>DMRS</sub> in the equivalent EVM<sub>DMRS</sub> sub-period.

For EVM the demodulation reference symbols are excluded, while the data symbols are used. For EVM<sub>DMRS</sub> the data symbols are excluded, while the demodulation references symbols are used. This is illustrated in figure E.4.6-1

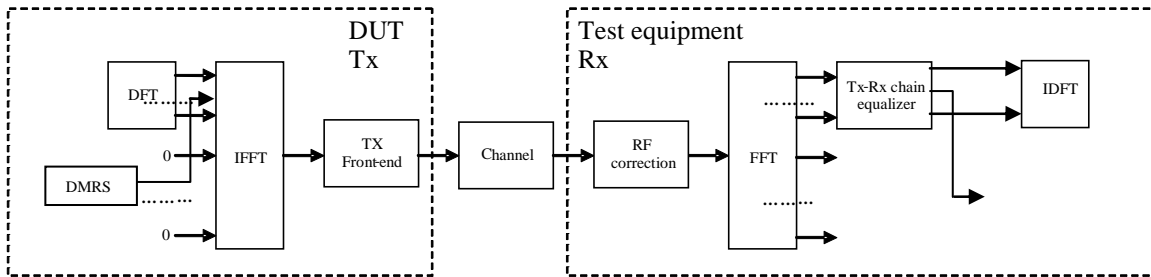


Figure E.4.6-1: EVM<sub>DMRS</sub> measurement points

Re-use the following formula from E.3.3:

$$Z'(f,t) = MS(f,t) \cdot EC(f)$$

To calculate EVM<sub>DMRS</sub>, the data symbol (t=0,1,3,4,5,6,8,9,10,12,13) in Z'(f,t) are excluded and only the reference symbols (t=2,7,11) is used.

The EVM<sub>DMRS</sub> is the difference between the ideal waveform and the measured and equalized waveform for the allocated RB(s)

$$EVM_{DMRS} = \sqrt{\frac{\sum_{t \in T} \sum_{f \in F} |Z'(f,t) - I(f,t)|^2}{|T| \cdot P_0 \cdot |F|}},$$

where

t covers the count of demodulation reference symbols (i.e. symbols 2,7,11 in each slot, so count=3)

f covers the count of demodulation reference symbols within the allocated bandwidth. (|F|=12\* L<sub>CRBs</sub> (with L<sub>CRBs</sub> : number of allocated resource blocks)).

Z'(f,t) are the samples of the signal evaluated for the EVM<sub>DMRS</sub>

I(f,t) is the ideal signal reconstructed by the measurement equipment, and

P<sub>0</sub> is the average power of the ideal signal. For normalized modulation symbols P<sub>0</sub> is equal to 1.

n such results are generated per measurement sub-period.

### E.4.6.1 1<sup>st</sup> average for EVM<sub>DMRS</sub>

EVM<sub>DMRS</sub> is averaged over all basic EVM<sub>DMRS</sub> measurements in one sub-period

The averaging comprises  $n$  UL slots

$$1stEVM_{DMRS} = \sqrt{\frac{1}{n} \sum_{i=1}^n (EVM_{DMRS,i})^2}$$

The timing is taken from the EVM for the data. 6 of those results are achieved from the samples. In general the timing is not the same for each result.

### E.4.6.2 Final average for EVM<sub>DMRS</sub>

$$finalEVM_{DMRS} = \sqrt{\frac{1}{6} \sum_{i=1}^6 (1stEVM_{DMRS,i})^2}$$

---

## E.5 EVM and inband emissions for PUCCH

For the purpose of worst case testing, the PUCCH shall be located on the edges of the Transmission Bandwidth Configuration (6,15,25,50,75,100 RBs).

The EVM for PUCCH (EVM<sub>PUCCH</sub>) is averaged over  $n$  slots, where



At least  $n$  TSs shall be transmitted by the UE without power change. SRS multiplexing shall be avoided during this period. The following transition periods are applicable: One OFDM symbol on each side of the slot border (instant of band edge alternation).

The description below is generic in the sense that all 5 PUCCH formats are covered. Although the number of OFDM symbols in one slot can be different from 7 (depending on the format, configuration and cyclic prefix length), the text below uses 7 without excluding the others.

### E.5.1 Basic principle

The basic principle is the same as described in E.2.1

### E.5.2 Output signal of the TX under test

The output signal of the TX under test is processed same as described in E.2.2

### E.5.3 Reference signal

The reference signal is defined same as in E.2.3. Same as in E.2.3,  $i_1(v)$  is the ideal reference for EVM<sub>PUCCH</sub> and  $i_2(v)$  is used to estimate the FFT window timing.

Note PUSCH is off during the PUCCH measurement period.

## E.5.4 Measurement results

The measurement results are:

- $EVM_{PUCCH}$
- Inband emissions with the sub-results: General in-band emission, IQ image (according to: 38.101. Annex F.4, Clause starting with: “At this stage the ....”)

## E.5.5 Measurement points

The measurement points are illustrated in the Figure E.2.5-1.

## E.5.6 Pre FFT minimization process

The pre FFT minimisation process is the same as describes in clause E.3.1.

NOTE: although an exclusion period for  $EVM_{PUCCH}$  is applicable in E.5.9.1, the pre FFT minimisation process is done over the complete slot.

RF error, and carrier leakage are necessary for best fit of the measured signal towards the ideal signal in the pre FFT domain. However they are not used to compare them against the limits.

## E.5.7 Timing of the FFT window

Timing of the FFT window is estimated with the same method as described in E.3.2.

## E.5.8 Post FFT equalisation

The post FFT equalisation is described separately without reference to E.3.3:

Perform 14 FFTs on  $z'(v)$ , one for each OFDM symbol in a slot using the timing  $\Delta\tilde{c}$ , including the demodulation reference symbol. The result is an array of samples, 14 in the time axis  $t$  times 2048 in the frequency axis  $f$ . The samples represent the OFDM symbols (data and reference symbols) in the allocated RBs and inband emissions in the non allocated RBs within the transmission BW.

Only the allocated resource blocks in the frequency domain are used for equalisation.

The nominal reference symbols and **nominal** OFDM data symbols are used to equalize the measured data symbols.

Note: (The nomenclature inside this note is local and not valid outside)

The nominal OFDM data symbols are created by a demodulation process. A demodulation process as follows is recommended:

1. Equalize the measured OFDM data symbols using the reference symbols for equalisation. Result: Equalized OFDM data symbols
2. Decide for the nearest constellation point, however not independent for each subcarrier in the RB. 12 constellation points are decided dependent, using the applicable CAZAC sequence. Result: Nominal OFDM data symbols

At this stage we have an array of Measured data-Symbols and reference-Symbols ( $MS(f,t)$ )

versus an array of Nominal data-Symbols and reference Symbols ( $NS(f,t)$ )

The arrays comprise in sum 7 data and reference symbols, depending on the PUCCH format, in the time axis and the number of allocated sub-carriers in the frequency axis.

$MS(f,t)$  and  $NS(f,t)$  are processed with a least square (LS) estimator, to derive one equalizer coefficient per time slot and per allocated subcarrier.  $EC(f)$

$$EC(f) = \frac{\sum_{t=0}^6 NS(f,t)^* NS(f,t)}{\sum_{t=0}^6 MS(f,t)^* NS(f,t)}$$

With \* denoting complex conjugation.

EC(f) are used to equalize the OFDM data together with the demodulation reference symbols by:

$$Z'(f,t) = MS(f,t) \cdot EC(f)$$

With · denoting multiplication.

Z'(f,t) is used to calculate EVM<sub>PUCCH</sub>, as described in E.5.9.1

NOTE: although an exclusion period for EVM<sub>PUCCH</sub> is applicable in E.5.9.1, the post FFT minimisation process is done over 7 OFDM symbols.

The samples of the non allocated resource blocks within the transmission bandwidth configuration in the post FFT domain are called Y(f,t) (f covering the non allocated subcarriers within the transmission bandwidth configuration, t covering the OFDM symbols during 1 slot).

## E.5.9 Derivation of the results

### E.5.9.1 EVM<sub>PUCCH</sub>

For EVM<sub>PUCCH</sub> create two sets of Z'(f,t), according to the timing "Δ $\tilde{c}$  -W/2 and Δ $\tilde{c}$  +W/2" using the equalizer coefficients from E.5.8

The EVM<sub>PUCCH</sub> is the difference between the ideal waveform and the measured and equalized waveform for the allocated RB(s)

$$EVM_{PUCCH} = \sqrt{\frac{\sum_{t \in T} \sum_{f \in F} |Z'(f,t) - I(f,t)|^2}{|T| \cdot P_0 \cdot |F|}},$$

where

the OFDM symbols next to transition borders (instant of PUCCH frequency hopping) are excluded:

t covers less than the count of demodulated symbols in the slot (|T|= 5)

f covers the count of subcarriers within the allocated bandwidth. (|F|=12)

Z'(f,t) are the samples of the signal evaluated for the EVM<sub>PUCCH</sub>

I(f,t) is the ideal signal reconstructed by the measurement equipment, and

P<sub>0</sub> is the average power of the ideal signal. For normalized modulation symbols P<sub>0</sub> is equal to 1.

From the acquired samples 2n EVM<sub>PUCCH</sub> value can be derived, n values for the timing Δ $\tilde{c}$  -W/2 and n values for the timing Δ $\tilde{c}$  +W/2

### E.5.9.2 Averaged EVM<sub>PUCCH</sub>

EVM<sub>PUCCH</sub> is averaged over all basic EVM<sub>PUCCH</sub> measurements

The averaging comprises  $n$  UL slots

$$\overline{EVM}_{PUCCH} = \sqrt{\frac{1}{n} \sum_{i=1}^n (EVM_{PUCCH,i})^2}$$

The averaging is done separately for timing!  $\Delta\tilde{c} -W/2$  and  $\Delta\tilde{c} +W/2$  leading to  $\overline{EVM}_{PUCCH,low}$  and  $\overline{EVM}_{PUCCH,high}$

$EVM_{PUCCH,final} = \max(\overline{EVM}_{PUCCH,low}, \overline{EVM}_{PUCCH,high})$  is compared against the test requirements.

### E.5.9.3 In-band emissions measurement

The in-band emissions are a measure of the interference falling into the non-allocated resources blocks

Create one set of  $Y(t,f)$  per slot according to the timing “ $\Delta\tilde{c}$ ”

For the non-allocated RBs the in-band emissions are calculated as follows

$$Emissions_{absolute}(\Delta_{RB}) = \begin{cases} \frac{1}{|T_s|} \sum_{t \in T_s} \sum_{c_l + (12 \cdot \Delta_{RB} + 11) \cdot \Delta f}^{c_l + (12 \cdot \Delta_{RB} + 11) \cdot \Delta f} |Y(t, f)|^2, \Delta_{RB} < 0 \\ \frac{1}{|T_s|} \sum_{t \in T_s} \sum_{c_h + (12 \cdot \Delta_{RB} - 11) \cdot \Delta f}^{\min(f_{max}, (c_h + 12 \cdot \Delta_{RB} \cdot \Delta f))} |Y(t, f)|^2, \Delta_{RB} > 0 \end{cases},$$

where

the upper formula represents the inband emissions below the allocated frequency block and the lower one the inband emissions above the allocated frequency block.

$T_s$  is a set of  $|T_s|$  OFDM symbols in the measurement period,

$\Delta_{RB}$  is the starting frequency offset between the allocated RB and the measured non-allocated RB (e.g.  $\Delta_{RB} = 1$  for the first upper or  $\Delta_{RB} = -1$  for the first lower adjacent RB),

$f_{min}$  and  $f_{max}$  are the lower and upper edge of the UL system BW,

$c_l$  and  $c_h$  are the lower and upper edge of the allocated BW,

$\Delta f$  is the SCS, and

$Y(t, f)$  is the frequency domain signal evaluated for in-band emissions as defined in the subsection E.5.8

The relative in-band emissions are, given by

$$Emissions_{relative}(\Delta_{RB}) = 10 * \log_{10} \frac{Emissions_{absolute}(\Delta_{RB})}{\frac{1}{|T_s|} \cdot L_{CRBs} \sum_{t \in T_s} \sum_{c_1}^{c_1 + (12 \cdot L_{CRBs} - 1) \cdot \Delta f} |MS(t, f)|^2} [dB]$$

where

$L_{CRBs}$  is the number of allocated RBs,

and  $MS(t, f)$  is the frequency domain samples for the allocated bandwidth, as defined in the subsection E.5.8

Although an exclusion period for EVM is applicable in E.5.9.1, the inband emissions measurement interval is defined over one complete slot in the time domain.

From the acquired samples  $n$  functions for inband emissions can be derived.

The in-band emissions are averaged over the  $n$  samples (equivalent to 10 UL subframes) with the same PUCCH position to prevent averaging of allocated and non-allocated RBs due to PUCCH frequency hopping:

$$\overline{Emissions}_{absolute}(\Delta_{RB}) = \frac{1}{n} \sum_{i=1}^n Emissions_{absolute,i}(\Delta_{RB})$$

$$\overline{Emissions}_{relative}(\Delta_{RB}) = 10 * \log_{10} \left( \frac{1}{n} \sum_{i=1}^n 10^{Emissions_{relative,i}(\Delta_{RB})/10} \right) \quad [dB]$$

Since the PUCCH allocation is always on the upper or lower band-edge, the opposite of the allocated one represents the IQ image, and the remaining inner RBs represent the general inband emissions. They are compared against different limits.

## E.6 EVM for PRACH

The description below is generic in the sense that all PRACH formats are covered. The numbers, used in the text below are taken from PRACH format B4 without excluding the other formats. The sampling rate for the PUSCH, 122.88 Mbps in the time domain, is re-used for the PRACH. The carrier spacing of the PUSCH is up to 48 times higher than that of PRACH depending on the PRACH format and SCS. This results in an oversampling factor  $ovf$  of up to 48, when acquiring the time samples for the PRACH. The pre-FFT algorithms (clauses E.6.6 and E.6.7) use all time samples, although oversampled. For the FFT the time samples are decimated by the  $ovf$ , resulting in the same FFT size as for the other transmit modulation tests. Decimation requires a decision, which samples are used and which ones are rejected. The algorithm in E.6.6, Timing of the FFT window, can also be used to decide about the used samples.

### E.6.1 Basic principle

The basic principle is the same as described in E.2.1

### E.6.2 Output signal of the TX under test

The output signal of the TX under test is processed same as described in E.2.2

The measurement period is different since 2 PRACH preambles are recorded for long preamble formats as defined in Table 6.3.3.1-1 in [9] and 10 preambles are recorded for short preamble formats as defined in Table 6.3.3.1-2 in [9].

### E.6.3 Reference signal

The test description in 6.4.2.1.4.1 is based on non-contention based access:

- PRACH configuration index (responsible for Preamble format, System frame number and subframe number)
- Preamble ID
- Preamble power

signalled to the UE, defines the reference signal unambiguously, such that no demodulation process is necessary to gain the reference signal.

The reference signal  $i(v)$  is constructed by the measuring equipment according to the relevant TX specifications, using the following parameters: the applicable Zadoff Chu sequence, nominal carrier frequency, nominal amplitude and phase

for each subcarrier, nominal timing, no carrier leakage. It is represented as a sequence of samples at a sampling rate of 122.88 Mbps in the time domain.

## E.6.4 Measurement results

The measurement result is:

- EVMPRACH

## E.6.5 Measurement points

The measurement points are illustrated in the figure below:

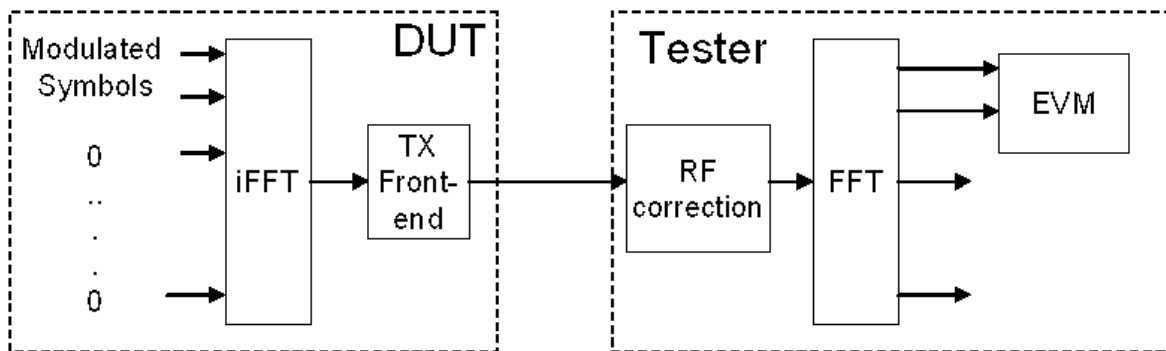


Figure E.6.5-1: Measurement points

## E.6.6 Pre FFT minimization process

The pre-FFT minimization process is applied to each PRACH preamble separately. The time period for the pre-FFT minimisation process includes the complete CP and Zadoff-Chu sequence (in other words, the power transition period is per definition outside of this time period) Sample timing, Carrier frequency and carrier leakage in  $z(v)$  are jointly varied in order to minimise the difference between  $z(v)$  and  $i(v)$ . Best fit (minimum difference) is achieved when the RMS difference value between  $z(v)$  and  $i(v)$  is an absolute minimum.

After this process the samples  $z(v)$  are called  $z^0(v)$ .

RF error, and carrier leakage are necessary for best fit of the measured signal towards the ideal signal in the pre FFT domain. However they are not used to compare them against the limits.

## E.6.7 Timing of the FFT window

The FFT window length is  $8192 \cdot 2^{\mu}$  samples for preamble format B4, however in the measurement period at least  $11936 \cdot 2^{\mu}$  samples are taken where  $\mu \in \{2,3\}$ . The position in time for FFT must be determined.

In an ideal signal, the FFT may start at any instant within the cyclic prefix without causing an error. The TX filter, however, reduces the window. The EVM requirements shall be met within a window  $W < CP$ .

The reference instant for the FFT start is the centre of the reduced window, called  $\Delta\tilde{c}$ ,

EVM is measured at the following two instants:  $\Delta\tilde{c} - W/2$  and  $\Delta\tilde{c} + W/2$ .

The timing of the measured signal  $z^0(v)$  with respect to the ideal signal  $i(v)$  is determined in the pre FFT domain as follows:

Correlation between  $z^0(v)$  and  $i(v)$  will result in a correlation peak. The meaning of the correlation peak is approx. the “impulse response” of the TX filter. The correlation peak, (the highest, or in case of more than one, the earliest) indicates the timing in the measured signal with respect to the ideal signal.

$W$  is different for different preamble formats and shown in Table E.6.7-1 for  $L_{RA} = 139$  and  $\Delta f^{RA} = 15 \cdot 2^\mu$  kHz where  $\mu \in \{2,3\}$ .

**Table E.6.7-1 EVM window length for PRACH formats for  $L_{RA} = 139$**

Preamble format	Cyclic prefix length $N_{cp}$	Nominal FFT size <sup>1</sup>	EVM window length $W$ in FFT samples	Ratio of $W$ to CP*
A1	1152 $\cdot 2^{-\mu}$	8192 $\cdot 2^{-\mu}$	576 $\cdot 2^{-\mu}$	50.0%
A2	2304 $\cdot 2^{-\mu}$	8192 $\cdot 2^{-\mu}$	1728 $\cdot 2^{-\mu}$	75.0%
A3	3456 $\cdot 2^{-\mu}$	8192 $\cdot 2^{-\mu}$	2880 $\cdot 2^{-\mu}$	83.3%
B1	864 $\cdot 2^{-\mu}$	8192 $\cdot 2^{-\mu}$	288 $\cdot 2^{-\mu}$	33.3%
B2	1440 $\cdot 2^{-\mu}$	8192 $\cdot 2^{-\mu}$	864 $\cdot 2^{-\mu}$	60.0%
B3	2016 $\cdot 2^{-\mu}$	8192 $\cdot 2^{-\mu}$	1440 $\cdot 2^{-\mu}$	71.4%
B4	3744 $\cdot 2^{-\mu}$	8192 $\cdot 2^{-\mu}$	3168 $\cdot 2^{-\mu}$	84.6%
C0	4960 $\cdot 2^{-\mu}$	8192 $\cdot 2^{-\mu}$	4384 $\cdot 2^{-\mu}$	88.4%
C2	8192 $\cdot 2^{-\mu}$	8192 $\cdot 2^{-\mu}$	7616 $\cdot 2^{-\mu}$	93.0%

Note 1: The use of other FFT sizes is possible as long as appropriate scaling of the window length is applied.  
Note 2: These percentages are informative.

The number of samples, used for FFT is reduced compared to  $z^0(v)$ . This subset of samples is called  $z''(v)$ .

The sample frequency 122.88 MHz is oversampled with respect to the PRACH-subcarrier spacing of  $\Delta f^{RA} = 15 \cdot 2^\mu$  kHz. EVM is based on 8192 $\cdot 2^{-\mu}$  samples per PRACH preamble and requires decimation of the time samples by the factor of  $12 \cdot 2^\mu$ . The final number of samples per PRACH preamble, used for FFT is reduced compared to  $z''(v)$  by the same factor. This subset of samples is called  $z'(v)$ .

## E.6.8 Post FFT equalisation

Equalisation is not applicable for the PRACH.

## E.6.9 Derivation of the results

### E.6.9.1 EVM<sub>PRACH</sub>

Perform FFT on  $z'(v)$  and  $i(v)$  using the FFT timing  $\Delta\tilde{c} - W/2$  and  $\Delta\tilde{c} + W/2$ .

For format B4 the first and the repeated preamble sequence are FFT-converted separately using the standard FFT length of 8192.

The EVM<sub>PRACH</sub> is the difference between the ideal waveform and the measured and equalized waveform for the allocated RB(s).

$$EVM_{PRACH} = \sqrt{\frac{\sum_{t \in T} \sum_{f \in F} |Z'(f, t) - I(f, t)|^2}{|T| \cdot P_0 \cdot |F|}}$$

where

$t$  covers the count of demodulated symbols in the slot.



$f$  covers the count of demodulated symbols within the allocated bandwidth.

$Z'(f, t)$  are the samples of the signal evaluated for the  $EVM_{PRACH}$

$I(f, t)$  is the ideal signal reconstructed by the measurement equipment, and

$P_0$  is the average power of the ideal signal. For normalized modulation symbols  $P_0$  is equal to 1.

From the acquired samples  $2m$   $EVM_{PRACH}$  values can be derived,  $m$  values for the timing  $\Delta\tilde{c} - W/2$  and  $m$  values for the timing  $\Delta\tilde{c} + W/2$ .

### E.6.9.2 Averaged $EVM_{PRACH}$

The PRACH EVM,  $EVM_{PRACH}$ , is averaged over  $m$  preamble sequence measurements.

$$\overline{EVM}_{PRACH} = \sqrt{\frac{1}{m} \sum_{i=1}^m (EVM_{PRACH,i})^2}$$

where  $m$  is the number of recorded preambles as defined in Annex E.6.2.

The averaging is done separately for timing  $\Delta\tilde{c} - W/2$  and  $\Delta\tilde{c} + W/2$  leading to  $\overline{EVM}_{PRACH,low}$  and  $\overline{EVM}_{PRACH,high}$

$EVM_{PRACH,final} = \max(\overline{EVM}_{PRACH,low}, \overline{EVM}_{PRACH,high})$  is compared against the test requirements.

## Annex F (normative): Measurement uncertainties and Test Tolerances

### F.1 Acceptable uncertainty of Test System (normative)

The maximum acceptable uncertainty of the Test System is specified below for each test, where appropriate. The Test System shall enable the stimulus signals in the test case to be adjusted to within the specified range, and the equipment under test to be measured with an uncertainty not exceeding the specified values. Care should be taken to ensure that each conformance test implementation including the OTA chamber aspects meets the specified measurement uncertainty for each test case by requiring the test laboratory to maintain a detailed measurement uncertainty test report showing compliance to all the measurement uncertainty requirements. The detailed measurement uncertainty report would contain the justification for each measurement uncertainty component and its value and distribution. The derivation of these values is based on the minimum conformance requirements plus relaxation, i.e., test tolerance is not to be considered. All ranges and uncertainties are absolute values, and are valid for a confidence level of 95 %, unless otherwise stated.

A confidence level of 95 % is the measurement uncertainty tolerance interval for a specific measurement that contains 95 % of the performance of a population of test equipment.

The downlink signal uncertainties apply at the defined quiet zone with the UE properly positioned in the quiet zone. The uplink signal uncertainties apply at the measurement equipment with the UE positioned properly in the quiet zone.

#### F.1.1 Measurement of test environments

**Editor's note: Various measurement accuracies for UE test environments, e.g., pressure, relative humidity, DC&AC voltage, vibration, and vibration frequency, are FFS:**

The measurement accuracy of the UE test environments defined in TS 38.508-1 [5] subclause 4.1, Test environments shall be

- Temperature  $\pm 4$  degrees.

The above values shall apply unless the test environment is otherwise controlled and the specification for the control of the test environment specifies the uncertainty for the parameter.

#### F.1.2 Measurement of transmitter

**Table F.1.2-1: Maximum Test System Uncertainty (MTSU) for transmitter tests**

Sub clause	Maximum Test System Uncertainty	Derivation of MTSU
6.2.1.1 UE maximum output power (EIRP)	PC3 Minimum peak EIRP, Max EIRP Max Device size $\leq 30$ cm $\pm 4.89$ dB (FR2a, NTC testing) $\pm 5.09$ dB (FR2b, NTC testing) $\pm 5.17$ dB (FR2a, ETC testing) $\pm 5.37$ dB (FR2b, ETC testing) PC1 Minimum peak EIRP, Max EIRP Max Device size $\leq 30$ cm $\pm [5.33]$ dB (FR2a, NTC testing) $\pm \text{TBD}$ dB (FR2b, NTC testing) $\pm \text{TBD}$ dB (FR2a, ETC testing) $\pm \text{TBD}$ dB (FR2b, ETC testing)	MTSU = $1.00 \times \text{MU}$ (from Table B.3-1 in TR 38.903)

6.2.1.1 UE maximum output power (TRP)	<p><u>PC3</u>  Max TRP  Max Device size ≤ 30 cm  ±4.42 dB (FR2a, NTC testing)  ±4.62 dB (FR2b, NTC testing)  ±4.70 dB (FR2a, ETC testing)  ±4.90 dB (FR2b, ETC testing)</p> <p>PC1  Max TRP  Max Device size ≤ 30 cm  ±[4.64] dB (FR2a, NTC testing)  ± TBD dB (FR2b, NTC testing)  ± TBD dB (FR2a, ETC testing)  ± TBD dB (FR2b, ETC testing)</p>	MTSU = 1.00 x MU (from Table B.3-2 in TR 38.903)
6.2.1.1_1 UE maximum output power – EIRP (Rel-16 and forward)	<u>Same as 6.2.1.1</u>	
6.2.1.2 UE maximum output power (Spherical coverage)	<p><u>PC3</u>  Max Device size ≤ 30 cm  ±4.60 dB (FR2a)  ±5.20 dB (FR2b)</p> <p>PC1  Max Device size ≤ 30 cm  TBD</p>	MTSU = 1.00 x MU (from Table B.3-3 in TR 38.903)
6.2.1.2_1 UE maximum output power – Spherical coverage (Rel16 and forward)	<u>Same as 6.2.1.2</u>	
6.2.2 UE maximum output power reduction	<p><u>PC3</u>  Max Device size ≤ 30 cm  ±4.92 dB (FR2a), NTC testing  ±5.10 dB (FR2b), NTC testing  ±5.20 dB (FR2a, ETC testing)  ±5.38 dB (FR2b, ETC testing)</p>	MTSU = 1.00 x MU (from Table B.4-1 in TR 38.903)
6.2.2_1 UE maximum output power reduction enhancements	<u>Same as 6.2.2</u>	
6.2.3 UE maximum output power with additional requirements	<u>Same as 6.2.2</u>	
6.2.4 Configured transmitted power	TBD	
6.2.4_1 Configured transmitted power with Power Boost	Same as 6.2.1.1	
6.2A.1.1.1 UE maximum output power - EIRP and TRP for CA (2UL CA)	<p><u>Intra-band contiguous CA</u>  Maximum aggregated BW ≤ 400MHz  Same as 6.2.1</p> <p>Maximum aggregated BW &gt; 400MHz  TBD</p> <p><u>Intra-band non-contiguous, Inter-band CA</u>  TBD</p>	
6.2A.1.1.2 UE maximum output power - EIRP and TRP for CA (3UL CA)	<p><u>Intra-band contiguous CA</u>  Maximum aggregated BW ≤ 400MHz  Same as 6.2.1</p> <p>Maximum aggregated BW &gt; 400MHz  TBD</p> <p><u>Intra-band non-contiguous, Inter-band CA</u>  TBD</p>	

6.2A.1.1.3 UE maximum output power - EIRP and TRP for CA (4UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.2.1  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.2A.1.1.4 UE maximum output power - EIRP and TRP for CA (5UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.2A.1.1.5 UE maximum output power - EIRP and TRP for CA (6UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.2A.1.1.6 UE maximum output power - EIRP and TRP for CA (7UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.2A.1.1.7 UE maximum output power - EIRP and TRP for CA (8UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.2A.1.2.1 Spherical coverage for CA (2UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.2.1.2  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.2A.1.2.2 Spherical coverage for CA (3UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.2.1.2  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.2A.1.2.3 Spherical coverage for CA (4UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.2.1.2  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.2A.1.2.4 Spherical coverage for CA (5UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.2A.1.2.5 Spherical coverage for CA (6UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.2A.1.2.6 Spherical coverage for CA (7UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.2A.1.2.7 Spherical coverage for CA (8UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.2A.2.1 UE maximum output power reduction for CA (2UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.2.2  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	MTSU = 1.00 x MU (from Table B.4-1 in TR 38.903)

6.2A.2.2 UE maximum output power reduction for CA (3UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.2.2  <u>Maximum aggregated BW &gt; 400MHz</u> TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.2A.2.3 UE maximum output power reduction for CA (4UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.2.2  <u>Maximum aggregated BW &gt; 400MHz</u> TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.2A.2.4 UE maximum output power reduction for CA (5UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.2A.2.5 UE maximum output power reduction for CA (6UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.2A.2.6 UE maximum output power reduction for CA (7UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.2A.2.7 UE maximum output power reduction for CA (8UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.2D.2 UE maximum output power reduction for UL MIMO	Same as 6.2.2	
6.2D.3 UE maximum output power with additional requirements for UL MIMO	Same as 6.2.3	
6.3.1 Minimum output power	<u>PC1</u> Minimum peak EIRP, Max EIRP Max Device size $\leq$ 30 cm FFS (FR2a) FFS dB (FR2b)  <u>PC3</u> Minimum peak EIRP, Max EIRP Max Device size $\leq$ 30 cm $\pm$ 6.15 dB (FR2a & FR2b, NTC testing) $\pm$ 6.41 dB (FR2a & FR2b, ETC testing))	MTSU = 1.00 x MU (from Table B.7-1 in TR 38.903)
6.3.2 Transmit OFF power	<u>PC3:</u> Max Device size $\leq$ 30 cm $\pm$ 5.67 dB (FR2a)  <u>PC1:</u> Max Device size $\leq$ 30 cm $\pm$ [5.67] dB (FR2a)	MTSU = 1.00 x MU (from Table B.8-1 in TR 38.903)
6.3.3.2 General ON/OFF time mask	ON power: Same as 6.2.1.1 (EIRP) for the respective power class OFF power: Same as 6.3.1 for the respective power class	
6.3.3.4 PRACH time mask	<u>PC3:</u> PRACH power: TBD OFF power: Max Device size $\leq$ 30 cm $\pm$ 6.15 dB (FR2a & FR2b, NTC testing) $\pm$ 6.41 dB (FR2a & FR2b, ETC testing)	
6.3.3.6 SRS time mask	TBD	

6.3.4.2 Absolute power tolerance	<u>PC3</u> Max Device size $\leq 30$ cm $\pm 8.05$ dB (FR2a & FR2b, NTC testing) $\pm 8.42$ dB (FR2a & FR2b, ETC testing)	MTSU = $\text{SQRT}(\text{UL Meas Uncer}^2 + \text{DL Meas Uncer}^2)$ UL Meas Uncer: Same as 6.3.1 DL Meas Uncer: Same as 7.3.2
6.3.4.3 Relative power tolerance	<u>PC3</u> Max Device size $\leq 30$ cm [ $\pm 1.7$ dB] (FR2a) [ $\pm 1.7$ dB] (FR2b)	MTSU = $1.00 \times \text{MU}$ (from Table B.9a.2.2-2 in TR 38.903)
6.3.4.4 Aggregate power tolerance	<u>PC3</u> Max Device size $\leq 30$ cm $\pm 1.4$ dB (FR2a) $\pm 1.4$ dB (FR2b)	MTSU = $1.00 \times \text{MU}$ (from Table B.9a.3.2-2 in TR 38.903)
6.3A.1.1 Minimum output power for CA (2UL CA)	For UL CA aggregated BW $\leq 800$ MHz: Same as 6.3.1 for each CC For UL CA aggregated BW $> 800$ MHz: TBD	
6.3A.1.2 Minimum output power for CA (3UL CA)	For UL CA aggregated BW $\leq 800$ MHz: Same as 6.3.1 for each CC For UL CA aggregated BW $> 800$ MHz: TBD	
6.3A.1.3 Minimum output power for CA (4UL CA)	For UL CA aggregated BW $\leq 800$ MHz: Same as 6.3.1 for each CC For UL CA aggregated BW $> 800$ MHz: TBD	
6.3A.1.4 Minimum output power for CA (5UL CA)	For UL CA aggregated BW $\leq 800$ MHz: Same as 6.3.1 for each CC For UL CA aggregated BW $> 800$ MHz: TBD	
6.3A.1.5 Minimum output power for CA (6UL CA)	For UL CA aggregated BW $\leq 800$ MHz: Same as 6.3.1 for each CC For UL CA aggregated BW $> 800$ MHz: TBD	
6.3A.1.6 Minimum output power for CA (7UL CA)	For UL CA aggregated BW $\leq 800$ MHz: Same as 6.3.1 for each CC For UL CA aggregated BW $> 800$ MHz: TBD	
6.3A.1.7 Minimum output power for CA (8UL CA)	For UL CA aggregated BW $\leq 800$ MHz: Same as 6.3.1 for each CC For UL CA aggregated BW $> 800$ MHz: TBD	
6.3A.3.1.1 General ON/OFF time mask for CA (2UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq 400$ MHz Same as 6.3.3  Maximum aggregated BW $> 400$ MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.3A.3.1.2 General ON/OFF time mask for CA (3UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq 400$ MHz Same as 6.3.3  Maximum aggregated BW $> 400$ MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.3A.3.1.3 General ON/OFF time mask for CA (4UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq 400$ MHz Same as 6.3.3  Maximum aggregated BW $> 400$ MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	

6.3A.3.1.4 General ON/OFF time mask for CA (5UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.3A.3.1.5 General ON/OFF time mask for CA (6UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.3A.3.1.6 General ON/OFF time mask for CA (7UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.3A.3.1.7 General ON/OFF time mask for CA (8UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.3A.4.2.1 Absolute power tolerance for CA (2UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.3.4.2 for each CC.  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.3A.4.2.2 Absolute power tolerance for CA (3UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.3.4.2 for each CC.  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.3A.4.2.3 Absolute power tolerance for CA (4UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.3.4.2 for each CC.  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.3A.4.2.4 Absolute power tolerance for CA (5UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.3.4.2 for each CC.  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.3A.4.2.5 Absolute power tolerance for CA (6UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.3.4.2 for each CC.  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.3A.4.2.6 Absolute power tolerance for CA (7UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.3.4.2 for each CC.  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	

6.3A.4.2.7 Absolute power tolerance for CA (8UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.3.4.2 for each CC.  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.3A.4.3.1 Relative power tolerance for CA (2UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz TBD  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.3A.4.3.2 Relative power tolerance for CA (3UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz TBD  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.3A.4.3.3 Relative power tolerance for CA (4UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz TBD  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.3A.4.3.4 Relative power tolerance for CA (5UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.3A.4.3.5 Relative power tolerance for CA (6UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.3A.4.3.6 Relative power tolerance for CA (7UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.3A.4.3.7 Relative power tolerance for CA (8UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.3A.4.4.1 Aggregate power tolerance for CA (2UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.3.4.4 for each CC.  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.3A.4.4.2 Aggregate power tolerance for CA (3UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.3.4.4 for each CC.  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	



6.3A.4.4.3 Aggregate power tolerance for CA (4UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.3.4.4 for each CC.  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.3A.4.4.4 Aggregate power tolerance for CA (5UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.3A.4.4.5 Aggregate power tolerance for CA (6UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.3A.4.4.6 Aggregate power tolerance for CA (7UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.3A.4.4.7 Aggregate power tolerance for CA (8UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.3D.3.1 General ON/OFF time mask for UL MIMO	PC3: <u>OFF Power</u> Max Device size $\leq$ 30cm $\pm$ 6.15 dB (FR2a) $\pm$ 6.15 dB (FR2b)  <u>ON Power</u> Quiet Zone size $\leq$ 30cm TBD (FR2a) TBD (FR2b)	<u>OFF Power</u> MTSU = 1.00 x MU (from Table B.8-2-4 in TR 38.903)  <u>ON Power</u> TBD
6.3D.3.4 SRS time mask for UL MIMO	PC3: <u>OFF Power</u> Max Device size $\leq$ 30cm $\pm$ 6.15 dB (FR2a) $\pm$ 6.15 dB (FR2b)  <u>ON Power</u> Quiet Zone size $\leq$ 30cm TBD (FR2a) TBD (FR2b)	<u>OFF Power</u> MTSU = 1.00 x MU (from Table B.8-2-4 in TR 38.903)  <u>ON Power</u> TBD
6.4.1 Frequency error	$\pm$ 0.01 ppm (NTC & ETC testing)	MTSU = 1.00 x MU (from B.10.1 and B.10.2 in TR 38.903)
6.4.2.1 Error vector magnitude	PUSCH, PC3, FR2a: As defined in Table F.1.2-2.  PUSCH, PC3, FR2b: As defined in Table F.1.2-3.  Otherwise: TBD	
6.4.2.2 Carrier leakage	<u>PC3</u> Max Device size $\leq$ 30 cm  $\pm$ 5.44 dB (FR2a) $\pm$ 5.57 dB (FR2b)  uplink absolute power measurement uncertainty: 6.15 dB (FR2a & FR2b, NTC testing) uplink relative power measurement uncertainty: 1.4 dB (FR2a & FR2b, NTC testing)	MTSU = 1.00 x MU (from Table B.11-1 in TR 38.903)
6.4.2.3 In-band emissions	TBD	
6.4.2.4 EVM equalizer spectrum flatness	TBD	
6.4.2.5 EVM equalizer spectrum flatness for BPSK modulation	TBD	

6.4A.1.1 Frequency error for CA (2UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.4.1  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.4A.1.2 Frequency error for CA (3UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.4.1  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.4A.1.3 Frequency error for CA (4UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.4.1  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.4A.1.4 Frequency error for CA (5UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.4A.1.5 Frequency error for CA (6UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.4A.1.6 Frequency error for CA (7UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.4A.1.7 Frequency error for CA (8UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.4A.2.1.1 Error Vector magnitude for CA (2UL CA)	TBD	
6.4A.2.1.2 Error Vector magnitude for CA (3UL CA)	TBD	
6.4A.2.1.3 Error Vector magnitude for CA (4UL CA)	TBD	
6.4A.2.1.4 Error Vector magnitude for CA (5UL CA)	TBD	
6.4A.2.1.5 Error Vector magnitude for CA (6UL CA)	TBD	
6.4A.2.1.6 Error Vector magnitude for CA (7UL CA)	TBD	
6.4A.2.1.7 Error Vector magnitude for CA (8UL CA)	TBD	
6.4A.2.2.1 Carrier leakage for CA (2UL CA)	<u>TBD</u>	
6.4A.2.2.2 Carrier leakage for CA (3UL CA)	<u>TBD</u>	
6.4A.2.2.3 Carrier leakage for CA (4UL CA)	<u>TBD</u>	
6.4A.2.2.4 Carrier leakage for CA (5UL CA)	<u>TBD</u>	
6.4A.2.2.5 Carrier leakage for CA (6UL CA)	<u>TBD</u>	
6.4A.2.2.6 Carrier leakage for CA (7UL CA)	<u>TBD</u>	
6.4A.2.2.7 Carrier leakage for CA (8UL CA)	<u>TBD</u>	
6.4A.2.3.1 In-band emissions for CA (2UL CA)	<u>TBD</u>	
6.4A.2.3.2 In-band emissions for CA (3UL CA)	<u>TBD</u>	

6.4A.2.3.3 In-band emissions for CA (4UL CA)	TBD	
6.4A.2.3.4 In-band emissions for CA (5UL CA)	TBD	
6.4A.2.3.5 In-band emissions for CA (6UL CA)	TBD	
6.4A.2.3.6 In-band emissions for CA (7UL CA)	TBD	
6.4A.2.3.7 In-band emissions for CA (8UL CA)	TBD	
6.5.1 Occupied bandwidth	<p>Max Device size <math>\leq</math> 30cm</p> <p>PC3: FR2a: <math>\pm 0.4</math> [%CBW] (BW 50MHz) <math>\pm 0.4</math> [%CBW] (BW 100MHz) <math>\pm 1.2</math> [%CBW] (BW 200MHz) <math>\pm 1.2</math> [%CBW] (BW 400MHz)</p> <p>FR2b: <math>\pm 0.4</math> [%CBW] (BW 50MHz) <math>\pm 0.4</math> [%CBW] (BW 100MHz) <math>\pm 1.3</math> [%CBW] (BW 200MHz) <math>\pm 1.3</math> [%CBW] (BW 400MHz)</p> <p>FR2c: TBD</p>	
6.5.2.1 Spectrum Emission Mask	<p>Max Device size <math>\leq</math> 30 cm</p> <p><math>\pm 4.94</math> dB (FR2a) <math>\pm 5.32</math> dB (FR2b)</p>	MTSU = 1.00 x MU (from Table B.16-1 in TR 38.903)
6.5.2.3 Adjacent Channel Leakage Ratio	<p>Max Device size <math>\leq</math> 30cm</p> <p>FR2a, NTC &amp; ETC testing: <math>\pm 5.63</math> dB (BW <math>\leq</math> 50MHz) <math>\pm 6.09</math> dB (50MHz &lt; BW <math>\leq</math> 100MHz) <math>\pm 6.09</math> dB (100MHz &lt; BW <math>\leq</math> 200MHz) <math>\pm 6.09</math> dB (200MHz &lt; BW <math>\leq</math> 400MHz)</p> <p>FR2b, NTC &amp; ETC testing: <math>\pm 6.09</math> dB (BW <math>\leq</math> 50MHz) <math>\pm 6.09</math> dB (50MHz &lt; BW <math>\leq</math> 100MHz) <math>\pm 6.09</math> dB (100MHz &lt; BW <math>\leq</math> 200MHz) <math>\pm 6.09</math> dB (200MHz &lt; BW <math>\leq</math> 400MHz)</p>	MTSU = 1.00 x MU (from Table B.17-1B in TR 38.903)
6.5.3.1 Transmitter Spurious emissions	<p>Max Device size <math>\leq</math> 30 cm</p> <p>Maximum in-band BW <math>\leq</math> 400MHz</p> <p><math>\pm 5.14</math> dB (6GHz <math>\leq</math> f <math>\leq</math> 12.75GHz) <math>\pm 5.11</math> dB (12.75GHz &lt; f <math>\leq</math> 23.45GHz) <math>\pm 5.41</math> dB (23.45GHz &lt; f &lt; 40.8GHz) <math>\pm 7.42</math> dB (40.8GHz <math>\leq</math> f <math>\leq</math> 66GHz) <math>\pm 7.72</math> dB (66GHz <math>\leq</math> f <math>\leq</math> 80GHz)</p>	MTSU = 1.00 x MU (from Table B.18-1 in TR 38.903)
6.5.3.2 Spurious emission band UE co-existence	<p>Max Device size <math>\leq</math> 30 cm</p> <p>Maximum in-band BW <math>\leq</math> 400MHz</p> <p>Protected band n260, n261, n257: <math>\pm 6.00</math> dB</p> <p>Protected frequency 23.6 GHz <math>\leq</math> f <math>\leq</math> 24.0 GHz: <math>\pm 6.00</math> dB</p> <p>Protected frequency 57 GHz <math>\leq</math> f <math>\leq</math> 66GHz: <math>\pm 8.01</math> dB</p> <p>Protected frequency 36 GHz <math>\leq</math> f <math>\leq</math> 37GHz: <math>\pm 6.00</math> dB</p>	MTSU = 1.00 x MU (from Table B.18-1a in TR 38.903)

6.5.3.3 Additional Spurious emission	<p>Max Device size <math>\leq 30</math> cm  Maximum in-band BW <math>\leq 400</math>MHz</p> <p><math>\pm 5.14</math> dB (<math>6\text{GHz} \leq f \leq 12.75\text{GHz}</math>), NS_202  <math>\pm 5.70</math> dB (<math>12.75\text{GHz} &lt; f \leq 23.45\text{GHz}</math>), NS_202  <math>\pm 6.00</math> dB (<math>23.45\text{GHz} &lt; f &lt; 40.8\text{GHz}</math>), NS_202, NS_203  <math>\pm 8.01</math> dB (<math>40.8\text{GHz} \leq f \leq 2\text{nd harmonic of the upper frequency edge of the UL operating band}</math>), NS_202</p>	MTSU = 1.00 x MU (from Table B.18-1b in TR 38.903)
6.5A.1.1 Occupied bandwidth for CA (2UL CA)	<p><u>Intra-band contiguous CA</u>  Maximum aggregated BW <math>\leq 400</math>MHz  Max Device size <math>\leq 30</math>cm</p> <p>PC3:  FR2a:  TBD</p> <p>FR2b:  TBD</p> <p>FR2c:  TBD</p> <p>Maximum aggregated BW <math>&gt; 400</math>MHz  TBD</p> <p><u>Intra-band non-contiguous, Inter-band CA</u>  TBD</p>	
6.5A.1.2 Occupied bandwidth for CA (3UL CA)	<p><u>Intra-band contiguous CA</u>  Maximum aggregated BW <math>\leq 400</math>MHz  Same as 6.5A.1.1</p> <p>Maximum aggregated BW <math>&gt; 400</math>MHz  TBD</p> <p><u>Intra-band non-contiguous, Inter-band CA</u>  TBD</p>	
6.5A.1.3 Occupied bandwidth for CA (4UL CA)	<p><u>Intra-band contiguous CA</u>  Maximum aggregated BW <math>\leq 400</math>MHz  Same as 6.5A.1.1</p> <p>Maximum aggregated BW <math>&gt; 400</math>MHz  TBD</p> <p><u>Intra-band non-contiguous, Inter-band CA</u>  TBD</p>	
6.5A.1.4 Occupied bandwidth for CA (5UL CA)	<p><u>Intra-band contiguous CA</u>  Maximum aggregated BW <math>\leq 400</math>MHz  Same as 6.5A.1.1</p> <p>Maximum aggregated BW <math>&gt; 400</math>MHz  TBD</p> <p><u>Intra-band non-contiguous, Inter-band CA</u>  TBD</p>	
6.5A.1.5 Occupied bandwidth for CA (6UL CA)	<p><u>Intra-band contiguous CA</u>  Maximum aggregated BW <math>\leq 400</math>MHz  Same as 6.5A.1.1</p> <p>Maximum aggregated BW <math>&gt; 400</math>MHz  TBD</p> <p><u>Intra-band non-contiguous, Inter-band CA</u>  TBD</p>	

6.5A.1.6 Occupied bandwidth for CA (7UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.5A.1.1  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.5A.1.7 Occupied bandwidth for CA (8UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.5A.1.1  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.5A.2.1.1 Spectrum Emission Mask for CA (2UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.5.2.1  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.5A.2.1.2 Spectrum Emission Mask for CA (3UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.5.2.1  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.5A.2.1.3 Spectrum Emission Mask for CA (4UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.5.2.1  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.5A.2.1.4 Spectrum Emission Mask for CA (5UL CA)	TBD	
6.5A.2.1.5 Spectrum Emission Mask for CA (6UL CA)	TBD	
6.5A.2.1.6 Spectrum Emission Mask for CA (7UL CA)	TBD	
6.5A.2.1.7 Spectrum Emission Mask for CA (8UL CA)	TBD	
6.5A.2.2.1 Adjacent channel leakage ratio for CA (2UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.5.2.3  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	MTSU = 1.00 x MU (from Table B.17-1B in TR 38.309)

6.5A.2.2.2 Adjacent channel leakage ratio for CA (3UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.5.2.3  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.5A.2.2.3 Adjacent channel leakage ratio for CA (4UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.5.2.3  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.5A.2.2.4 Adjacent channel leakage ratio for CA (5UL CA)	Intra-band contiguous CA 400 MHz < aggregated BW $\leq$ TBD MHz  Intra-band non-contiguous CA TBD	
6.5A.2.2.5 Adjacent channel leakage ratio for CA (6UL CA)	Intra-band contiguous CA 400 MHz < aggregated BW $\leq$ TBD MHz  Intra-band non-contiguous CA TBD	
6.5A.2.2.6 Adjacent channel leakage ratio for CA (7UL CA)	Intra-band contiguous CA 400 MHz < aggregated BW $\leq$ TBD MHz  Intra-band non-contiguous CA TBD	
6.5A.2.2.7 Adjacent channel leakage ratio for CA (8UL CA)	Intra-band contiguous CA 400 MHz < aggregated BW $\leq$ TBD MHz  Intra-band non-contiguous CA TBD	
6.5A.3.1.1 Transmitter Spurious emissions for CA (2UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.5.3.1  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.5A.3.1.2 Transmitter Spurious emissions for CA (3UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.5.3.1  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.5A.3.1.3 Transmitter Spurious emissions for CA (4UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.5.3.1  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.5A.3.1.4 Transmitter Spurious emissions for CA (5UL CA)	Intra-band contiguous CA 400 MHz < aggregated BW $\leq$ TBD MHz  Intra-band non-contiguous CA TBD	

6.5A.3.1.5 Transmitter Spurious emissions for CA (6UL CA)	Intra-band contiguous CA 400 MHz < aggregated BW ≤ TBD MHz  Intra-band non-contiguous CA TBD	
6.5A.3.1.6 Transmitter Spurious emissions for CA (7UL CA)	Intra-band contiguous CA 400 MHz < aggregated BW ≤ TBD MHz  Intra-band non-contiguous CA TBD	
6.5A.3.1.7 Transmitter Spurious emissions for CA (8UL CA)	Intra-band contiguous CA 400 MHz < aggregated BW ≤ TBD MHz  Intra-band non-contiguous CA TBD	
6.5A.3.2.1 Spurious emission band UE co-existence for CA (2UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW ≤ 400MHz Same as 6.5.3.2  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.5A.3.2.2 Spurious emission band UE co-existence for CA (3UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW ≤ 400MHz Same as 6.5.3.2  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.5A.3.2.3 Spurious emission band UE co-existence for CA (4UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW ≤ 400MHz Same as 6.5.3.2  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.5A.3.2.4 Spurious emission band UE co-existence for CA (5UL CA)	TBD	
6.5A.3.2.5 Spurious emission band UE co-existence for CA (6UL CA)	TBD	
6.5A.3.2.6 Spurious emission band UE co-existence for CA (7UL CA)	TBD	
6.5A.3.2.7 Spurious emission band UE co-existence for CA (8UL CA)	TBD	
6.5A.3.3.1 Additional spurious emissions for CA (2UL CA)	TBD	
6.5A.3.3.2 Additional spurious emissions for CA (3UL CA)	TBD	
6.5A.3.3.3 Additional spurious emissions for CA (4UL CA)	TBD	
6.5A.3.3.4 Additional spurious emissions for CA (5UL CA)	TBD	
6.5A.3.3.5 Additional spurious emissions for CA (6UL CA)	TBD	
6.5A.3.3.6 Additional spurious emissions for CA (7UL CA)	TBD	
6.5A.3.3.7 Additional spurious emissions for CA (8UL CA)	TBD	
6.5D.2.1 Spectrum Emission Mask for UL MIMO	Same as 6.5.2.1	

6.5D.2.2 Adjacent channel leakage ratio for UL MIMO	Same as 6.5.2.3	
6.6.1 Beam correspondence – EIRP	PC3 Max Device size ≤ 30 cm 2.67 dB (FR2a, NTC testing) 3.80 dB (FR2b, NTC testing)	MTSU = 1.00 x MU (from Table B.18a.2-2 in TR 38.309)
6.6.2 Enhanced Beam correspondence - EIRP	Same as 6.6.1	
NOTE 1: FR2a: 23.45GHz ≤ f ≤ 32.125GHz FR2b: 32.125GHz ≤ f ≤ 40.8GHz FR2c: 40.8GHz ≤ f ≤ 44.3GHz		

**Table F.1.2-2: EVM Measurement Uncertainty (MU) for PUSCH, PC3, FR2a (23.45GHz ≤ f ≤ 32.125GHz)**

Test ID	Modulation	RB alloc.	50MHz	100MHz	200MHz	400MHz
1	DFT-s-OFDM PI/2 BPSK	Inner_Full	2.78%	3.85%	5.44%	7.69%
2	DFT-s-OFDM PI/2 BPSK	Outer_Full	3.10%	4.16%	5.88%	8.99%
3	DFT-s-OFDM QPSK	Inner_Full	2.78%	3.85%	5.44%	7.69%
4	DFT-s-OFDM QPSK	Outer_Full	3.10%	4.16%	5.88%	8.99%
5	DFT-s-OFDM 16 QAM	Inner_Full	3.31%	4.50%	6.36%	11.21%
6	DFT-s-OFDM 16 QAM	Outer_Full	3.60%	4.73%	6.68%	11.21%
7	DFT-s-OFDM 64 QAM	Inner_Full	4.26%	5.96%	8.41%	15.84%
8	DFT-s-OFDM 64 QAM	Outer_Full	5.01%	7.08%	9.99%	15.84%
9	CP-OFDM QPSK	Inner_Full	3.60%	4.73%	6.68%	11.89%
10	CP-OFDM QPSK	Outer_Full	3.71%	4.99%	7.07%	11.89%
11	CP-OFDM 16 QAM	Inner_Full	4.26%	5.96%	8.41%	15.84%
12	CP-OFDM 16 QAM	Outer_Full	4.26%	5.96%	8.41%	15.84%
13	CP-OFDM 64 QAM	Inner_Full	6.31%	8.91%	12.59%	21.13%
14	CP-OFDM 64 QAM	Outer_Full	6.31%	8.91%	12.59%	21.13%

**Table F.1.2-3: EVM Measurement Uncertainty (MU) for PUSCH, PC3, FR2b (32.125GHz < f ≤ 40.8GHz)**

Test ID	Modulation	RB alloc.	50MHz	100MHz	200MHz	400MHz
1	DFT-s-OFDM PI/2 BPSK	Inner_Full	3.56%	4.83%	6.91%	9.65%
2	DFT-s-OFDM PI/2 BPSK	Outer_Full	4.15%	5.69%	8.11%	12.50%
3	DFT-s-OFDM QPSK	Inner_Full	3.56%	4.83%	6.91%	9.65%
4	DFT-s-OFDM QPSK	Outer_Full	4.15%	5.69%	8.11%	12.50%
5	DFT-s-OFDM 16 QAM	Inner_Full	4.54%	6.26%	8.91%	18.06%
6	DFT-s-OFDM 16 QAM	Outer_Full	5.09%	7.19%	10.15%	18.06%
7	DFT-s-OFDM 64 QAM	Inner_Full	6.78%	9.58%	13.54%	25.50%
8	DFT-s-OFDM 64 QAM	Outer_Full	8.06%	11.38%	16.09%	25.50%
9	CP-OFDM QPSK	Inner_Full	5.09%	7.19%	10.15%	19.13%
10	CP-OFDM QPSK	Outer_Full	5.39%	7.61%	10.75%	19.13%
11	CP-OFDM 16 QAM	Inner_Full	6.78%	9.58%	13.54%	25.50%
12	CP-OFDM 16 QAM	Outer_Full	6.78%	9.58%	13.54%	25.50%
13	CP-OFDM 64 QAM	Inner_Full	10.14%	14.33%	20.25%	34.01%
14	CP-OFDM 64 QAM	Outer_Full	10.14%	14.33%	20.25%	34.01%



## F.1.3 Measurement of receiver

**Table F.1.3-1: Maximum Test System Uncertainty (MTSU) for receiver tests**

Sub clause	Maximum Test System Uncertainty	Derivation of MTSU
7.3.2 Reference sensitivity power level	<u>PC3</u> Max Device size ≤ 30 cm ±5.19 dB (FR2a, FR2b, NTC testing) ±5.45 dB (FR2a, FR2b, ETC testing)  <u>PC1</u> Max Device size ≤ 30 cm ±[5.58] dB (FR2a, NTC testing) ± TBD dB (FR2a, ETC testing)	MTSU = 1.00 x MU (from Table B.19-1 in TR 38.903)
7.3.4 EIS spherical coverage	<u>PC3</u> ±4.90 dB (Max Device size ≤ 30 cm, FR2a, FR2b)  <u>PC1</u> <u>TBD</u>	MTSU = 1.00 x MU (from Table B.19-2 in TR 38.903)
7.3A.2.1 Reference sensitivity power level for CA (2DL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW ≤ 400MHz Same as 7.3.2 for each component carrier  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
7.3A.2.2 Reference sensitivity power level for CA (3DL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW ≤ 400MHz Same as 7.3.2 for each component carrier  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
7.3A.2.3 Reference sensitivity power level for CA (4DL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW ≤ 400MHz Same as 7.3.2 for each component carrier  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
7.3A.2.4 Reference sensitivity power level for CA (5DL CA)	TBD	
7.3A.2.5 Reference sensitivity power level for CA (6DL CA)	TBD	
7.3A.2.6 Reference sensitivity power level for CA (7DL CA)	TBD	
7.3A.2.7 Reference sensitivity power level for CA (8DL CA)	TBD	
7.3A.3.1 EIS spherical coverage for CA (2DL CA)	<u>TBD</u>	
7.3A.3.2 EIS spherical coverage for CA (3DL CA)	<u>TBD</u>	
7.3A.3.3 EIS spherical coverage for CA (4DL CA)	<u>TBD</u>	
7.3A.3.4 EIS spherical coverage for CA (5DL CA)	<u>TBD</u>	
7.3A.3.5 EIS spherical coverage for CA (6DL CA)	<u>TBD</u>	
7.3A.3.6 EIS spherical coverage for CA (7DL CA)	<u>TBD</u>	

7.3A.3.7 EIS spherical coverage for CA (8DL CA)	TBD	
7.4 Maximum input level	TBD	
7.4A.1 Maximum input level for CA (2DL CA)	TBD	
7.4A.2 Maximum input level for CA (3DL CA)	TBD	
7.4A.3 Maximum input level for CA (4DL CA)	TBD	
7.4A.4 Maximum input level for CA (5DL CA)	TBD	
7.4A.5 Maximum input level for CA (6DL CA)	TBD	
7.4A.6 Maximum input level for CA (7DL CA)	TBD	
7.4A.7 Maximum input level for CA ((DL CA)	TBD	
7.5 Adjacent channel selectivity	<p>PC3  <math>\pm 7.84</math> dB (Max Device size <math>\leq 30</math> cm, FR2a, FR2b)</p> <p>PC1  <math>\pm [8.31]</math> dB (Max Device size <math>\leq 30</math> cm, FR2a)</p>	MTSU = 1.00 x MU (from Table B.21-1 in TR 38.903)
7.5A.1 Adjacent channel selectivity for CA (2UL CA)	TBD	
7.5A.2 Adjacent channel selectivity for CA (3UL CA)	TBD	
7.5A.3 Adjacent channel selectivity for CA (4UL CA)	TBD	
7.5A.4 Adjacent channel selectivity for CA (5UL CA)	TBD	
7.5A.5 Adjacent channel selectivity for CA (6UL CA)	TBD	
7.5A.6 Adjacent channel selectivity for CA (7UL CA)	TBD	
7.5A.7 Adjacent channel selectivity for CA (8UL CA)	TBD	
7.6.2 In-band blocking	Same as 7.5	
7.6A.2.1 In-band blocking for CA (2UL CA)	TBD	
7.6A.2.2 In-band blocking for CA (3UL CA)	TBD	
7.6A.2.3 In-band blocking for CA (4UL CA)	TBD	
7.6A.2.4 In-band blocking for CA (5UL CA)	TBD	
7.6A.2.5 In-band blocking for CA (6UL CA)	TBD	
7.6A.2.6 In-band blocking for CA (7UL CA)	TBD	
7.6A.2.7 In-band blocking for CA (8UL CA)	TBD	
7.9 Spurious emissions	<p>Max Device size <math>\leq 30</math> cm  Maximum in-band BW <math>\leq 400</math>MHz</p> <p>For Band n257, n258, n260, n261:  <math>\pm 5.50</math>dB (<math>6\text{GHz} \leq f \leq 12.75\text{GHz}</math>)  <math>\pm 5.46</math>dB (<math>12.75\text{GHz} &lt; f \leq 23.45\text{GHz}</math>)  <math>\pm 6.11</math>dB (<math>23.45\text{GHz} &lt; f &lt; 40.8\text{GHz}</math>)  <math>\pm 7.65</math>dB (<math>40.8\text{GHz} \leq f \leq 66\text{GHz}</math>)  <math>\pm 7.95</math> dB (<math>66\text{GHz} \leq f \leq 80\text{GHz}</math>)</p>	MTSU = 1.00 x MU (from Table B.25-1 in TR 38.903)
NOTE 1: FR2a, FR2b and FR2c are specified in Table F.1.2-1.		

## F.2 Interpretation of measurement results (normative)

The actual measurement uncertainty of the Test System for the measurement of each parameter shall be included in the test report.

The recorded value for the Test System uncertainty shall be, for each measurement, equal to or lower than the appropriate figure in clause F.1 of the present document.

If the Test System using one of the permitted test methods defined in TR38.903 [20] for a test is known to have a measurement uncertainty greater than that specified in clause F.1, it is still permitted to use this apparatus provided that an adjustment is made value as follows:

Any additional uncertainty in the Test System over and above that specified in clause F.1 shall be used to tighten the Test Requirement, making the test harder to pass. For some tests, for example receiver tests, this may require modification of stimulus signals. This procedure will ensure that a Test System not compliant with clause F.1 does not increase the chance of passing a device under test where that device would otherwise have failed the test if a Test System compliant with clause F.1 had been used.

## F.3 Test Tolerance and Derivation of Test Requirements (informative)

TBD

### F.3.1 Measurement of test environments

TBD

### F.3.2 Measurement of transmitter

**Editor's note:** This clause is incomplete. The following aspects are either missing or not yet determined:

- Influence of noise is subtracted from MTSU before calculating the TT for lower limit Tx test cases.

**Table F.3.2-1: Derivation of Test Requirements (Transmitter tests)**

Sub clause	Test Tolerance (TT)	Formula for test requirement
6.2.1.1 UE maximum output power (EIRP)	<p><u>PC3</u> Minimum peak EIRP IFF (Max Device size ≤ 30 cm) 2.87 dB (FR2a, NTC) 2.87 dB (FR2b, NTC) 3.04 dB (FR2a, ETC) 3.04 dB (FR2b, ETC)</p> <p>PC1 Minimum peak EIRP IFF (Max Device size ≤ 30 cm) [3.12] dB (FR2a, NTC) TBD dB (FR2b, NTC) TBD dB (FR2a, ETC) TBD dB (FR2b, ETC)</p> <p>Max EIRP 0 dB</p>	<p>PC3 Minimum peak EIRP <math>TT = 0.60 \times (MTSU_{IFF} - 0.1)</math> (FR2a) <math>TT = 0.60 \times (MTSU_{IFF} - 0.3)</math> (FR2b)</p> <p>PC1 Minimum peak EIRP <math>TT = 0.60 \times (MTSU_{IFF} - [0.13])</math> (FR2a) TT = TBD (FR2b)</p>
6.2.1.1 UE maximum output power (TRP)	<p><u>PC3</u> Max TRP IFF (Max Device size ≤ 30 cm) 2.65 dB (FR2a, NTC) 2.77 dB (FR2b, NTC) 2.82 dB (FR2a, ETC)</p>	<p>Max TRP <math>TT = 0.60 \times MTSU_{IFF}</math></p>

	2.94 dB (FR2b, ETC)  PC1 Max TRP IFF (Max Device size $\leq$ 30 cm) [2.78] dB (FR2a, NTC) TBD dB (FR2b, NTC) TBD dB (FR2a, ETC) TBD dB (FR2b, ETC)	
6.2.1.1_1 UE maximum output power – EIRP (Rel-16 and forward)	<u>Same as 6.2.1.1</u>	
6.2.1.2 UE maximum output power (Spherical coverage)	PC1 TBD  PC2 TBD  PC3 IFF (Max Device size $\leq$ 30 cm) 2.58 dB (FR2a) 2.58 dB (FR2b)  PC4 TBD	PC3 $TT = 0.60 \times (MTSU_{IFF} - 0.3)$ (FR2a) $TT = 0.60 \times (MTSU_{IFF} - 0.9)$ (FR2b)  PC1 TBD
6.2.1.2_1 UE maximum output power – Spherical coverage (Rel16 and forward)	<u>Same as 6.2.1.2</u>	
6.2.2 UE maximum output power reduction	PC3 Minimum peak EIRP IFF (Max Device size $\leq$ 30 cm) 3.11 dB (FR2a, NTC) 3.11 dB (FR2b, NTC) 3.30 dB (FR2a, ETC) 3.30 dB (FR2b, ETC)	Minimum peak EIRP $TT = 0.65 \times (MTSU_{IFF} - 0.13)$ (FR2a) $TT = 0.65 \times (MTSU_{IFF} - 0.31)$ (FR2b)
6.2.2_1 UE maximum output power reduction enhancements	<u>Same as 6.2.2</u>	
6.2.3 UE maximum output power with additional requirements	Same as 6.2.2	
6.2.4 Configured transmitted power	TBD	
6.2.4_1 Configured transmitted power with Power Boost	<u>Same as 6.2.1.1</u>	
6.2A.1.1.1 UE maximum output power - EIRP and TRP for CA (2UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.2.1  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous</u> TBD	
6.2A.1.1.2 UE maximum output power - EIRP and TRP for CA (3UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.2.1  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous</u> TBD	
6.2A.1.1.3 UE maximum	<u>Intra-band contiguous CA</u>	

output power - EIRP and TRP for CA (4UL CA)	Maximum aggregated BW $\leq$ 400MHz Same as 6.2.1  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous</u> TBD	
6.2A.1.1.4 UE maximum output power - EIRP and TRP for CA (5UL CA)	<u>Intra-band contiguous CA, Intra-band non-contiguous CA</u> TBD	
6.2A.1.1.5 UE maximum output power - EIRP and TRP for CA (6UL CA)	<u>Intra-band contiguous CA, Intra-band non-contiguous CA</u> TBD	
6.2A.1.1.6 UE maximum output power - EIRP and TRP for CA (7UL CA)	<u>Intra-band contiguous CA, Intra-band non-contiguous CA</u> TBD	
6.2A.1.1.7 UE maximum output power - EIRP and TRP for CA (8UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.2A.1.2.1 Spherical coverage for CA (2UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz <u>Same as 6.2.1.2</u>  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.2A.1.2.2 Spherical coverage for CA (3UL CA)	Maximum aggregated BW $\leq$ 400MHz <u>Same as 6.2.1.2</u>  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.2A.1.2.3 Spherical coverage for CA (4UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz <u>Same as 6.2.1.2</u>  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.2A.1.2.4 Spherical coverage for CA (5UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.2A.1.2.5 Spherical coverage for CA (6UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.2A.1.2.6 Spherical coverage for CA (7UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.2A.1.2.7 Spherical coverage for CA (8UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.2A.2.1 UE maximum output power reduction for CA (2UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz <u>Same as 6.2.2</u>  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.2A.2.2 UE maximum output power reduction for CA (3UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz <u>Same as 6.2.2</u>	

	<p><u>Maximum aggregated BW &gt; 400MHz</u> <u>TBD</u></p> <p><u>Intra-band non-contiguous, Inter-band CA</u> <u>TBD</u></p>	
6.2A.2.3 UE maximum output power reduction for CA (4UL CA)	<p><u>Intra-band contiguous CA</u> <u>Maximum aggregated BW ≤ 400MHz</u> <u>Same as 6.2.2</u></p> <p><u>Maximum aggregated BW &gt; 400MHz</u> <u>TBD</u></p> <p><u>Intra-band non-contiguous, Inter-band CA</u> <u>TBD</u></p>	
6.2A.2.4 UE maximum output power reduction for CA (5UL CA)	<u>Intra-band contiguous CA</u> <u>TBD</u>	
6.2A.2.5 UE maximum output power reduction for CA (6UL CA)	<u>Intra-band contiguous CA</u> <u>TBD</u>	
6.2A.2.6 UE maximum output power reduction for CA (7UL CA)	<u>Intra-band contiguous CA</u> <u>TBD</u>	
6.2A.2.7 UE maximum output power reduction for CA (8UL CA)	<u>Intra-band contiguous CA</u> <u>TBD</u>	
6.2D.2 UE maximum output power reduction for UL MIMO	Same as 6.2.2	
6.2D.3 UE maximum output power with additional requirements for UL MIMO	Same as 6.2.3	
6.3.1 Minimum output power	<p><u>PC3</u></p> <p>Minimum EIRP IFF (Max Device size ≤ 30 cm) NTC 4.21 dB (FR2a 50 MHz) 2.52 dB (FR2a 100 MHz) 0.66 dB (FR2a 200 MHz) 0 dB (FR2a 400 MHz)</p> <p>1.17 dB (FR2b 50 MHz) 0 dB (FR2b 100 MHz) 0 dB (FR2b 200 MHz) 0 dB (FR2b 400 MHz)</p> <p>ETC 4.37 dB (FR2a 50 MHz) 2.68 dB (FR2a 100 MHz) 0.82 dB (FR2a 200 MHz) 0 dB (FR2a 400 MHz)</p> <p>1.33 dB (FR2b 50 MHz) 0 dB (FR2b 100 MHz) 0 dB (FR2b 200 MHz) 0 dB (FR2b 400 MHz)</p>	<p>Minimum EIRP <math>TT = \max(R, \Delta SNR_{mr} + 0.65 \times (MTSU_{IFF} - 1.0)) - R</math></p> <p>R: Relaxation needed to limit influence of TE noise to 1 dB (specified in clause 6.3.1.5) <math>\Delta SNR_{mr}</math>: Systematic offset due to noise when measuring at minimum requirement level (-13 dBm)</p> <p>FR2a 50 MHz: <math>\Delta SNR_{mr} = 0.86</math> dB FR2a 100 MHz: <math>\Delta SNR_{mr} = 1.57</math> dB FR2a 200 MHz: <math>\Delta SNR_{mr} = 2.71</math> dB FR2a 400 MHz: <math>\Delta SNR_{mr} = 4.35</math> dB</p> <p>FR2b 50 MHz: <math>\Delta SNR_{mr} = 2.32</math> dB FR2b 100 MHz: <math>\Delta SNR_{mr} = 3.82</math> dB FR2b 200 MHz: <math>\Delta SNR_{mr} = 5.82</math> dB FR2b 400 MHz: <math>\Delta SNR_{mr} = 8.21</math> dB</p>
6.3.2 Transmit OFF power	0 dB	
6.3.3.2 General ON/OFF time mask	<p><u>PC3:</u> <u>ON Power</u> Same as 6.2.1.1 (EIRP) <u>OFF Power</u> 0 dB</p>	<p><u>ON Power:</u> Same as 6.2.1.1 (EIRP) <u>OFF Power:</u> Same as 6.3.1</p>
6.3.3.4 PRACH time mask	<p><u>PC3:</u> <u>OFF Power</u> Max Device size ≤ 30cm 0 dB</p> <p><u>ON Power</u> Max Device size ≤ 30cm</p>	<p><u>ON Power</u> TBD</p>

	TBD (FR2a) TBD (FR2b)TBD	
6.3.4.2 Absolute power tolerance	PC3 Max Device size $\leq 30$ cm $\pm 8.05$ dB (FR2a & FR2b, NTC testing) $\pm 8.42$ dB (FR2a & FR2b, ETC testing)	TT = MTSU
6.3.4.3 Relative power tolerance	PC3 IFF (Max Device size $\leq 30$ cm) [0.46 dB] (FR2a) [0.46 dB] (FR2b)	PC3 TT = $0.65 \times (\text{MTSU}_{\text{IFF}} - 1.0)$ (FR2a) TT = $0.65 \times (\text{MTSU}_{\text{IFF}} - 1.0)$ (FR2b) (assuming a power step $\Delta P = 1$ dB)
6.3.4.4 Aggregate power tolerance	PC3 IFF (Max Device size $\leq 30$ cm) 0.26 dB (FR2a) 0.26 dB (FR2b)	PC3 TT = $0.65 \times (\text{MTSU}_{\text{IFF}} - 1.0)$ (FR2a) TT = $0.65 \times (\text{MTSU}_{\text{IFF}} - 1.0)$ (FR2b) (assuming a power step $\Delta P = 1$ dB)
6.3A.1.1 Minimum output power for CA (2UL CA)	For UL CA aggregated BW $\leq 800$ MHz: Same as 6.3.1 For UL CA aggregated BW $> 800$ MHz: TBD	
6.3A.1.2 Minimum output power for CA (3UL CA)	For UL CA aggregated BW $\leq 800$ MHz: Same as 6.3.1 For UL CA aggregated BW $> 800$ MHz: TBD	
6.3A.1.3 Minimum output power for CA (4UL CA)	For UL CA aggregated BW $\leq 800$ MHz: Same as 6.3.1 For UL CA aggregated BW $> 800$ MHz: TBD	
6.3A.1.4 Minimum output power for CA (5UL CA)	For UL CA aggregated BW $\leq 800$ MHz: Same as 6.3.1 For UL CA aggregated BW $> 800$ MHz: TBD	
6.3A.1.5 Minimum output power for CA (6UL CA)	For UL CA aggregated BW $\leq 800$ MHz: Same as 6.3.1 For UL CA aggregated BW $> 800$ MHz: TBD	
6.3A.1.6 Minimum output power for CA (7UL CA)	For UL CA aggregated BW $\leq 800$ MHz: Same as 6.3.1 For UL CA aggregated BW $> 800$ MHz: TBD	
6.3A.1.7 Minimum output power for CA (8UL CA)	For UL CA aggregated BW $\leq 800$ MHz: Same as 6.3.1 For UL CA aggregated BW $> 800$ MHz: TBD	
6.3A.3.1.1 General ON/OFF time mask for CA (2UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq 400$ MHz Same as 6.3.3  Maximum aggregated BW $> 400$ MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.3A.3.1.2 General ON/OFF time mask for CA (3UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq 400$ MHz Same as 6.3.3  Maximum aggregated BW $> 400$ MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.3A.3.1.3 General ON/OFF time mask for CA (4UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq 400$ MHz Same as 6.3.3  Maximum aggregated BW $> 400$ MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u>	

	TBD	
6.3A.3.1.4 General ON/OFF time mask for CA (5UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.3A.3.1.5 General ON/OFF time mask for CA (6UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.3A.3.1.6 General ON/OFF time mask for CA (7UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.3A.3.1.7 General ON/OFF time mask for CA (8UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.3D.3.1 General ON/OFF time mask for UL MIMO	PC3: <u>OFF Power</u> Max Device size $\leq$ 30cm 0 dB  <u>ON Power</u> Max Device size $\leq$ 30cm TBD (FR2a) TBD (FR2b)	<u>ON Power</u> TBD
6.3D.3.4 SRS time mask for UL MIMO	PC3: <u>OFF Power</u> Max Device size $\leq$ 30cm 0 dB  <u>ON Power</u> Max Device size $\leq$ 30cm TBD (FR2a) TBD (FR2b)	<u>ON Power</u> TBD
6.3A.4.2.1 Absolute power tolerance for CA (2UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.3.4.2 for each CC. Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.3A.4.2.2 Absolute power tolerance for CA (3UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.3.4.2 for each CC. Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.3A.4.2.3 Absolute power tolerance for CA (4UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.3.4.2 for each CC. Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.3A.4.2.4 Absolute power tolerance for CA (5UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.3.4.2 for each CC. Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.3A.4.2.5 Absolute power tolerance for CA (6UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.3.4.2 for each CC. Maximum aggregated BW > 400MHz TBD	



	<u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.3A.4.2.6 Absolute power tolerance for CA (7UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.3.4.2 for each CC. Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.3A.4.2.7 Absolute power tolerance for CA (8UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.3.4.2 for each CC. Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.3A.4.3.1 Relative power tolerance for CA (2UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz TBD  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.3A.4.3.2 Relative power tolerance for CA (3UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz TBD  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.3A.4.3.3 Relative power tolerance for CA (4UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz TBD  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.3A.4.3.4 Relative power tolerance for CA (5UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.3A.4.3.5 Relative power tolerance for CA (6UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.3A.4.3.6 Relative power tolerance for CA (7UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.3A.4.3.7 Relative power tolerance for CA (8UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.3A.4.4.1 Aggregate power tolerance for CA (2UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.3.4.4 for each CC.  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.3A.4.4.2 Aggregate power tolerance for CA (3UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.3.4.4 for each CC.	

	<p>Maximum aggregated BW &gt; 400MHz TBD</p> <p><u>Intra-band non-contiguous, Inter-band CA</u> TBD</p>	
6.3A.4.4.3 Aggregate power tolerance for CA (4UL CA)	<p><u>Intra-band contiguous CA</u> Maximum aggregated BW ≤ 400MHz Same as 6.3.4.4 for each CC.</p> <p>Maximum aggregated BW &gt; 400MHz TBD</p> <p><u>Intra-band non-contiguous, Inter-band CA</u> TBD</p>	
6.3A.4.4.4 Aggregate power tolerance for CA (5UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.3A.4.4.5 Aggregate power tolerance for CA (6UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.3A.4.4.6 Aggregate power tolerance for CA (7UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.3A.4.4.7 Aggregate power tolerance for CA (8UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.4.1 Frequency error	0.005 ppm (NTC & ETC testing)	TT = 0.5 x MTSU
6.4.2.1 Error vector magnitude	<p>PUSCH, PC3, FR2a: As defined in Table 6.4.2.1.5-2.</p> <p>PUSCH, PC3, FR2b: As defined in Table 6.4.2.1.5-3.</p>	<p>Minimum requirement + TT</p> <p>EVM_meas_Increase = sqrt(Minimum requirement<sup>2</sup> + MTSU<sup>2</sup>) - Minimum requirement; it is the increase of measured EVM due to test equipment uncertainty.</p> <p>EVM_meas_Increase_Relative = EVM_meas_Increase / Minimum requirement [%]</p> <p>If (EVM_meas_Increase_Relative &lt; 7.5%) TT = 0%</p> <p>Else if (7.5% ≤ EVM_meas_Increase_Relative ≤ 50%) TT = EVM_meas_Increase</p> <p>Else Skip the test as not testable.</p>
6.4.2.2 Carrier leakage	<p>IFF (Max Device size ≤ 30 cm) FR2a: ±3.54 dB (BW ≤ 400MHz)</p> <p>FR2b: ±3.62 dB (BW ≤ 400MHz)</p>	TT = 0.65 x MTSU <sub>IFF</sub>
6.4.2.3 In-band emissions	TBD	
6.4.2.4 EVM equalizer spectrum flatness	TBD	
6.4.2.5 EVM equalizer spectrum flatness for BPSK modulation	TBD	
6.4A.1.1 Frequency error for CA (2UL CA)	<p><u>Intra-band contiguous CA</u> Maximum aggregated BW ≤ 400MHz Same as 6.4.1</p> <p>Maximum aggregated BW &gt; 400MHz TBD</p> <p><u>Intra-band non-contiguous, Inter-band CA</u> TBD</p>	
6.4A.1.2 Frequency error for	<u>Intra-band contiguous CA</u>	

CA (3UL CA)	Maximum aggregated BW $\leq$ 400MHz Same as 6.4.1  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.4A.1.3 Frequency error for CA (4UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.4.1  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.4A.1.4 Frequency error for CA (5UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.4A.1.5 Frequency error for CA (6UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.4A.1.6 Frequency error for CA (7UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.4A.1.7 Frequency error for CA (8UL CA)	<u>Intra-band contiguous CA</u> TBD	
6.4A.2.1.1 Error Vector magnitude for CA (2UL CA)	<u>TBD</u>	
6.4A.2.1.2 Error Vector magnitude for CA (3UL CA)	<u>TBD</u>	
6.4A.2.1.3 Error Vector magnitude for CA (4UL CA)	<u>TBD</u>	
6.4A.2.1.4 Error Vector magnitude for CA (5UL CA)	<u>TBD</u>	
6.4A.2.1.5 Error Vector magnitude for CA (6UL CA)	<u>TBD</u>	
6.4A.2.1.6 Error Vector magnitude for CA (7UL CA)	<u>TBD</u>	
6.4A.2.1.7 Error Vector magnitude for CA (8UL CA)	<u>TBD</u>	
6.4A.2.2.1 Carrier leakage for CA (2UL CA)	<u>TBD</u>	
6.4A.2.2.2 Carrier leakage for CA (3UL CA)	<u>TBD</u>	
6.4A.2.2.3 Carrier leakage for CA (4UL CA)	<u>TBD</u>	
6.4A.2.2.4 Carrier leakage for CA (5UL CA)	<u>TBD</u>	
6.4A.2.2.5 Carrier leakage for CA (6UL CA)	<u>TBD</u>	
6.4A.2.2.6 Carrier leakage for CA (7UL CA)	<u>TBD</u>	
6.4A.2.2.7 Carrier leakage for CA (8UL CA)	<u>TBD</u>	
6.4A.2.3.1 In-band emissions for CA (2UL CA)	<u>TBD</u>	
6.4A.2.3.2 In-band emissions for CA (3UL CA)	<u>TBD</u>	
6.4A.2.3.3 In-band emissions for CA (4UL CA)	<u>TBD</u>	
6.4A.2.3.4 In-band emissions for CA (5UL CA)	<u>TBD</u>	
6.4A.2.3.5 In-band emissions for CA (6UL CA)	<u>TBD</u>	
6.4A.2.3.6 In-band emissions for CA (7UL CA)	<u>TBD</u>	
6.4A.2.3.7 In-band emissions for CA (8UL CA)	<u>TBD</u>	

6.5.1 Occupied bandwidth	0 kHz	Minimum requirement + TT
6.5.2.1 Spectrum Emission Mask	IFF (Max Device size $\leq$ 30 cm) 3.21 dB (FR2a) 3.46 dB (FR2b)	$TT = 0.65 \times MTSU_{IFF}$
6.5.2.3 Adjacent Channel Leakage Ratio	<u>Absolute requirement</u> 0 dB  <u>Relative requirement</u> IFF (Max Device size $\leq$ 30 cm) FR2a: $\pm 4.66$ dB (BW $\leq$ 50MHz) $\pm 4.96$ dB (50MHz < BW $\leq$ 100MHz) $\pm 4.96$ dB (100MHz < BW $\leq$ 200MHz) $\pm 4.96$ dB (200MHz < BW $\leq$ 400MHz)  FR2b: $\pm 4.96$ dB (BW $\leq$ 50MHz) $\pm 4.96$ dB (50MHz < BW $\leq$ 100MHz) $\pm 4.96$ dB (100MHz < BW $\leq$ 200MHz) $\pm 4.96$ dB (200MHz < BW $\leq$ 400MHz)	$TT = \max(R, \Delta SNR_{mr} + 0.65 \times (MTSU_{IFF} - 1.0)) - R + TT$ due to metric change  TT due to metric change : 1.0 dB R: Relaxation needed to limit influence of TE noise to 1 dB (specified in clause 6.5.2.3.5) $\Delta SNR_{mr}$ : Systematic offset due to noise when measuring ACP at minimum requirement level
6.5.3.1 Transmitter Spurious emissions	0 dB	Minimum requirement + TT
6.5.3.2 Spurious emission band UE co-existence	0 dB	Minimum requirement + TT
6.5.3.3 Additional spurious emission	0 dB	Minimum requirement + TT
6.5A.1.1 Occupied bandwidth for CA (2UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.5.1  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.5A.1.2 Occupied bandwidth for CA (3UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.5.1  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.5A.1.3 Occupied bandwidth for CA (4UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.5.1  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.5A.1.4 Occupied bandwidth for CA (5UL CA)	TBD	
6.5A.1.5 Occupied bandwidth for CA (6UL CA)	TBD	
6.5A.1.6 Occupied bandwidth for CA (7UL CA)	TBD	
6.5A.1.7 Occupied bandwidth for CA (8UL CA)	TBD	
6.5A.2.1.1 Spectrum Emission Mask for CA (2UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.5.2.1  Maximum aggregated BW > 400MHz TBD	

	<u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.5A.2.1.2 Spectrum Emission Mask for CA (3UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.5.2.1  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.5A.2.1.3 Spectrum Emission Mask for CA (4UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.5.2.1  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.5A.2.1.4 Spectrum Emission Mask for CA (5UL CA)	TBD	
6.5A.2.1.5 Spectrum Emission Mask for CA (6UL CA)	TBD	
6.5A.2.1.6 Spectrum Emission Mask for CA (7UL CA)	TBD	
6.5A.2.1.7 Spectrum Emission Mask for CA (8UL CA)	TBD	
6.5A.2.2.1 Adjacent channel leakage ratio for CA (2UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.5.2.3  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	TT = 0.65 x MTSU <sub>IFF</sub> + TT due to metric change  TT due to metric change : 1.0 dB
6.5A.2.2.2 Adjacent channel leakage ratio for CA (3UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.5.2.3  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	TT = 0.65 x MTSU <sub>IFF</sub> + TT due to metric change  TT due to metric change : 1.0 dB
6.5A.2.2.3 Adjacent channel leakage ratio for CA (4UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW $\leq$ 400MHz Same as 6.5.2.3  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	TT = 0.65 x MTSU <sub>IFF</sub> + TT due to metric change  TT due to metric change : 1.0 dB
6.5A.2.2.4 Adjacent channel leakage ratio for CA (5UL CA)	Intra-band contiguous CA 400 MHz < aggregated BW $\leq$ TBD MHz  Intra-band non-contiguous CA TBD	TBD
6.5A.2.2.5 Adjacent channel leakage ratio for CA (6UL CA)	Intra-band contiguous CA 400 MHz < aggregated BW $\leq$ TBD MHz  Intra-band non-contiguous CA TBD	TBD

6.5A.2.2.6 Adjacent channel leakage ratio for CA (7UL CA)	Intra-band contiguous CA 400 MHz < aggregated BW ≤ TBD MHz  Intra-band non-contiguous CA TBD	TBD
6.5A.2.2.7 Adjacent channel leakage ratio for CA (8UL CA)	Intra-band contiguous CA 400 MHz < aggregated BW ≤ TBD MHz  Intra-band non-contiguous CA TBD	TBD
6.5A.3.1.1 Transmitter Spurious emissions for CA (2UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW ≤ 400MHz Same as 6.5.3.1  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.5A.3.1.2 Transmitter Spurious emissions for CA (3UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW ≤ 400MHz Same as 6.5.3.1  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.5A.3.1.3 Transmitter Spurious emissions for CA (4UL CA)	<u>Intra-band contiguous CA</u> Maximum aggregated BW ≤ 400MHz Same as 6.5.3.1  Maximum aggregated BW > 400MHz TBD  <u>Intra-band non-contiguous, Inter-band CA</u> TBD	
6.5A.3.1.4 Transmitter Spurious emissions for CA (5UL CA)	<u>Intra-band contiguous CA</u> 400 MHz < aggregated BW ≤ TBD MHz  Intra-band non-contiguous CA TBD	TBD
6.5A.3.1.5 Transmitter Spurious emissions for CA (6UL CA)	<u>Intra-band contiguous CA</u> 400 MHz < aggregated BW ≤ TBD MHz  Intra-band non-contiguous CA TBD	TBD
6.5A.3.1.6 Transmitter Spurious emissions for CA (7UL CA)	<u>Intra-band contiguous CA</u> 400 MHz < aggregated BW ≤ TBD MHz  Intra-band non-contiguous CA TBD	TBD
6.5A.3.1.7 Transmitter Spurious emissions for CA (8UL CA)	<u>Intra-band contiguous CA</u> 400 MHz < aggregated BW ≤ TBD MHz  Intra-band non-contiguous CA TBD	TBD
6.5D.2.1 Spectrum Emission Mask for UL MIMO	<u>Same as 6.5.2.1</u>	
6.5D.2.2 Adjacent channel leakage ratio for UL MIMO	<u>Same as 6.5.2.3</u>	
6.6.1 Beam correspondence - EIRP	PC3 1.26 dB (FR2a, FR2b)	PC3  TT = 0.60 x (MTSU <sub>IFF</sub> - ΔSNR <sub>mr</sub> )  ΔSNR <sub>mr</sub> : Systematic offset due to noise when measuring at minimum requirement level
6.6.2 Enhanced Beam correspondence - EIRP	Same as 6.6.1	
NOTE 1: FR2a: 23.45GHz ≤ f ≤ 32.125GHz FR2b: 32.125GHz ≤ f ≤ 40.8GHz FR2c: 40.8GHz ≤ f ≤ 44.3GHz		

### F.3.3 Measurement of receiver

**Table F.3.3-1: Derivation of Test Requirements (Receiver tests)**

Sub clause	Test Tolerance (TT)	Formula for test requirement
7.3.2 Reference sensitivity power level	<p><u>PC3</u> IFF (Max Device size ≤ 30 cm) 2.34 dB (FR2a, FR2b, NTC) 2.45 dB (FR2a, FR2b, ETC)</p> <p><u>PC1</u> IFF (Max Device size ≤ 30 cm) [2.51] dB (FR2a, NTC) TBD dB (FR2a, ETC)</p>	$TT = 0.45 \times MTSU_{IFF}$
7.3.4 EIS spherical coverage	<p><u>PC3</u> IFF (Max Device size ≤ 30 cm, FR2a, FR2b) 2.21 dB</p> <p><u>PC1</u> TBD</p>	$TT = 0.45 \times MTSU_{IFF}$
7.3A.2.1 Reference sensitivity power level for CA (2DL CA)	<p><u>Intra-band contiguous CA</u> Maximum aggregated BW ≤ 400MHz Same as 7.3.2 for each component carrier</p> <p>Maximum aggregated BW &gt; 400MHz TBD</p> <p><u>Intra-band non-contiguous, Inter-band CA</u> TBD</p>	
7.3A.2.2 Reference sensitivity power level for CA (3DL CA)	<p><u>Intra-band contiguous CA</u> Maximum aggregated BW ≤ 400MHz Same as 7.3.2 for each component carrier</p> <p>Maximum aggregated BW &gt; 400MHz TBD</p> <p><u>Intra-band non-contiguous, Inter-band CA</u> TBD</p>	
7.3A.2.3 Reference sensitivity power level for CA (4DL CA)	<p><u>Intra-band contiguous CA</u> Maximum aggregated BW ≤ 400MHz Same as 7.3.2 for each component carrier</p> <p>Maximum aggregated BW &gt; 400MHz TBD</p> <p><u>Intra-band non-contiguous, Inter-band CA</u> TBD</p>	
7.3A.2.4 Reference sensitivity power level for CA (5DL CA)	<p><u>Intra-band contiguous CA</u> TBD</p>	
7.3A.2.5 Reference sensitivity power level for CA (6DL CA)	<p><u>Intra-band contiguous CA</u> TBD</p>	
7.3A.2.6 Reference sensitivity power level for CA (7DL CA)	<p><u>Intra-band contiguous CA</u> TBD</p>	
7.3A.2.7 Reference sensitivity power level for CA (8DL CA)	<p><u>Intra-band contiguous CA</u> TBD</p>	
7.3A.3.1 EIS spherical coverage for CA (2DL CA)	<u>TBD</u>	
7.3A.3.2 EIS spherical coverage for CA (3DL CA)	<u>TBD</u>	
7.3A.3.3 EIS spherical coverage for CA (4DL CA)	<u>TBD</u>	
7.3A.3.4 EIS spherical coverage for CA (5DL CA)	<u>TBD</u>	
7.3A.3.5 EIS spherical coverage for CA (6DL CA)	<u>TBD</u>	
7.3A.3.6 EIS spherical coverage for CA (7DL CA)	<u>TBD</u>	

7.3A.3.7 EIS spherical coverage for CA (8DL CA)	<u>TBD</u>	
7.4 Maximum input level	<u>TBD</u>	
7.4A.1 Maximum input level for CA (2DL CA)	<u>TBD</u>	
7.4A.2 Maximum input level for CA (3DL CA)	<u>TBD</u>	
7.4A.3 Maximum input level for CA (4DL CA)	<u>TBD</u>	
7.4A.4 Maximum input level for CA (5DL CA)	<u>TBD</u>	
7.4A.5 Maximum input level for CA (6DL CA)	<u>TBD</u>	
7.4A.6 Maximum input level for CA (7DL CA)	<u>TBD</u>	
7.4A.7 Maximum input level for CA ((DL CA)	<u>TBD</u>	
7.5 Adjacent channel selectivity	<u>0 dB</u>	Wanted signal power + TT T-put limit unchanged
7.5A.1 Adjacent channel selectivity for CA (2UL CA)	<u>TBD</u>	
7.5A.2 Adjacent channel selectivity for CA (3UL CA)	<u>TBD</u>	
7.5A.3 Adjacent channel selectivity for CA (4UL CA)	<u>TBD</u>	
7.5A.4 Adjacent channel selectivity for CA (5UL CA)	<u>TBD</u>	
7.5A.5 Adjacent channel selectivity for CA (6UL CA)	<u>TBD</u>	
7.5A.6 Adjacent channel selectivity for CA (7UL CA)	<u>TBD</u>	
7.5A.7 Adjacent channel selectivity for CA (8UL CA)	<u>TBD</u>	
7.6.2 In-band blocking	<u>0 dB</u>	Wanted signal power + TT T-put limit unchanged
7.6A.2.1 In-band blocking for CA (2UL CA)	<u>TBD</u>	
7.6A.2.2 In-band blocking for CA (3UL CA)	<u>TBD</u>	
7.6A.2.3 In-band blocking for CA (4UL CA)	<u>TBD</u>	
7.6A.2.4 In-band blocking for CA (5UL CA)	<u>TBD</u>	
7.6A.2.5 In-band blocking for CA (6UL CA)	<u>TBD</u>	
7.6A.2.6 In-band blocking for CA (7UL CA)	<u>TBD</u>	
7.6A.2.7 In-band blocking for CA (8UL CA)	<u>TBD</u>	
7.9 Spurious emissions	<u>0 dB</u>	Minimum requirement + TT T-put limit unchanged
NOTE 1: FR2a, FR2b and FR2c are specified in Table F.3.2-1.		



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## F.4 Uplink power window

### F.4.1 Introduction

A number of Tx and Rx Test cases set the UE uplink power to be within a defined window to ensure the test is carried out in the intended conditions. This clause gives the method for calculating the uplink power window used in Tx test cases and Rx Test cases.

### F.4.2 Setting the power window above a requirement

The method used to derive the uplink power window for NR FR2 is defined in TS 38.521-3 [14] clause F.4.2.2.

### F.4.3 Setting the power window below a requirement

The method used to derive the uplink power window for NR FR2 is defined in TS 38.521-3 [14] clause F.4.3.2.

### F.4.4 Setting the power window centred on a target value

The method used to derive the uplink power window for NR FR2 is defined in TS 38.521-3 [14] clause F.4.4.2.

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## Annex G (normative): Uplink Physical Channels

### G.0 Uplink Signal Levels

Please refer to Annex G.0 in TS 38.521-1 [13].

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### G.1 General

Please refer to Annex G.1 in TS 38.521-1 [13].

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### G.2 Set-up

Please refer to Annex G.2 in TS 38.521-1 [13].

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### G.3 Connection

Please refer to Annex G.3 in TS 38.521-1 [13].

#### G.3.0 Measurement of Transmitter Characteristics

Please refer to Annex G.3.0 in TS 38.521-1 [13].

#### G.3.1 Measurement of Receiver Characteristics

Please refer to Annex G.3.1 in TS 38.521-1 [13].

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# Annex H (normative): Statistical Testing

*Editor's Note: Further investigate the technical details behind this statistical method to ensure that this is applicable for FR2 radiated test cases.*

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## H.1 General

This annex specifies mapping throughput to error ratio, pass fail limits and pass fail decision rules that are needed for measuring average throughput for a duration sufficient to achieve statistical significance for testing receiver characteristics.

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## H.2 Statistical testing of receiver characteristics

### H.2.1 General

The test of receiver characteristics is twofold.

1. A signal or a combination of signals is offered to the RX port(s) of the receiver.
2. The ability of the receiver to demodulate /decode this signal is verified by measuring the throughput.

In (2) is the statistical aspect of the test and is treated here.

The minimum requirement for all receiver tests is >95% of the maximum throughput.

All receiver tests are performed in static propagation conditions. No fading conditions are applied.

### H.2.2 Mapping throughput to error ratio

- a) The measured information bit throughput  $R$  is defined as the sum (in kilobits) of the information bit payloads successfully received during the test interval, divided by the duration of the test interval (in seconds).
- b) In measurement practice the UE indicates successfully received information bit payload by signalling an ACK to the SS.  
If payload is received, but damaged and cannot be decoded, the UE signals a NACK.
- c) Only the ACK and NACK signals, not the data bits received, are accessible to the SS.  
The number of bits is known in the SS from knowledge of what payload was sent.
- d) For the reference measurement channel, applied for testing, the number of bits is different in different slots, however in a radio frame it is fixed during one test.
- e) The time in the measurement interval is composed of successfully received slots (ACK), unsuccessfully received slots (NACK) and no reception at all (DTX-slots).
- f) DTX-slots may occur regularly according the applicable reference measurement channel (regDTX).  
In real live networks this is the time when other UEs are served. In TDD these are the UL and special slots. regDTX vary from test to test but are fixed within the test.
- g) Additional DTX-slots occur statistically when the UE is not responding ACK or NACK where it should. (statDTX)  
This may happen when the UE was not expecting data or decided that the data were not intended for it.

The pass / fail decision is done by observing the:

- number of NACKs
- number of ACKs and
- number of statDTXs (regDTX is implicitly known to the SS)

The ratio  $(NACK + statDTX) / (NACK + statDTX + ACK)$  is the Error Ratio (ER). Taking into account the time consumed by the ACK, NACK, and DTX-TTIs (regular and statistical), ER can be mapped unambiguously to throughput for any single reference measurement channel test.

### H.2.3 Design of the test

The test is defined by the following design principles (see clause H.x, Theory....):

1. The early decision concept is applied.
2. A second limit is introduced: Bad DUT factor  $M > 1$
3. To decide the test pass:

Supplier risk is applied based on the Bad DUT quality

To decide the test fail

Customer Risk is applied based on the specified DUT quality

The test is defined by the following parameters:

1. Limit ER = 0.05 (Throughput limit = 95%)
2. Bad DUT factor  $M = 1.5$  (selectivity)
3. Confidence level CL = 95% (for specified DUT and Bad DUT-quality)

### H.2.4 Numerical definition of the pass fail limits

**Table H.2.4-1: pass fail limits**

ne	ns <sub>p</sub>	ns <sub>f</sub>	ne	ns <sub>p</sub>	ns <sub>f</sub>	ne	ns <sub>p</sub>	ns <sub>f</sub>	ne	ns <sub>p</sub>	ns <sub>f</sub>
0	67	NA	39	763	500	78	1366	1148	117	1951	1828
1	95	NA	40	778	516	79	1381	1166	118	1965	1845
2	119	NA	41	794	532	80	1396	1183	119	1980	1863
3	141	NA	42	810	548	81	1412	1200	120	1995	1881
4	162	NA	43	826	564	82	1427	1217	121	2010	1899
5	183	NA	44	842	580	83	1442	1234	122	2025	1916
6	202	NA	45	858	596	84	1457	1252	123	2039	1934
7	222	NA	46	873	612	85	1472	1269	124	2054	1952
8	241	NA	47	889	629	86	1487	1286	125	2069	1969
9	259	NA	48	905	645	87	1502	1303	126	2084	1987
10	278	76	49	920	661	88	1517	1321	127	2099	2005
11	296	88	50	936	678	89	1532	1338	128	2113	2023
12	314	100	51	952	694	90	1547	1355	129	2128	2040
13	332	113	52	967	711	91	1562	1373	130	2143	2058
14	349	126	53	983	727	92	1577	1390	131	2158	2076
15	367	140	54	998	744	93	1592	1407	132	2172	2094
16	384	153	55	1014	760	94	1607	1425	133	2187	2111
17	401	167	56	1029	777	95	1623	1442	134	2202	2129
18	418	181	57	1045	793	96	1637	1459	135	2217	2147
19	435	195	58	1060	810	97	1652	1477	136	2231	2165

20	452	209	59	1076	827	98	1667	1494	137	2246	2183
21	469	224	60	1091	844	99	1682	1512	138	2261	2201
22	486	238	61	1106	860	100	1697	1529	139	2275	2218
23	503	253	62	1122	877	101	1712	1547	140	2290	2236
24	519	268	63	1137	894	102	1727	1564	141	2305	2254
25	536	283	64	1153	911	103	1742	1582	142	2320	2272
26	552	298	65	1168	928	104	1757	1599	143	2334	2290
27	569	313	66	1183	944	105	1772	1617	144	2349	2308
28	585	328	67	1199	961	106	1787	1634	145	2364	2326
29	602	343	68	1214	978	107	1802	1652	146	2378	2344
30	618	359	69	1229	995	108	1817	1669	147	2393	2361
31	634	374	70	1244	1012	109	1832	1687	148	2408	2379
32	650	389	71	1260	1029	110	1847	1704	149	2422	2397
33	667	405	72	1275	1046	111	1861	1722	150	2437	2415
34	683	421	73	1290	1063	112	1876	1740	151	2452	2433
35	699	436	74	1305	1080	113	1891	1757	152	2466	2451
36	715	452	75	1321	1097	114	1906	1775	153*)	NA	2469
37	731	468	76	1336	1114	115	1921	1793			
38	747	484	77	1351	1131	116	1936	1810	*) note 2 in H.2.5		

NOTE 1: The first column is the number of errors ( $n_e$  = number of NACK + statDTX)

NOTE 2: The second column is the number of samples for the pass limit ( $n_{s_p}$ ,  $n_{s_p}$  = Number of Samples = number of NACK + statDTX + ACK)

NOTE 3: The third column is the number of samples for the fail limit ( $n_{s_f}$ )

## H.2.5 Pass fail decision rules

The pass fail decision rules apply for a single test, comprising one component in the test vector. The overall Pass /Fail conditions are defined in clause H.2.6 and H.2.A.6

Having observed 0 errors, pass the test at 67+ samples, otherwise continue

Having observed 1 error, pass the test at 95+ otherwise continue

Having observed 2 errors, pass the test at 119+ samples, fail the test at 2- samples, otherwise continue

Etc. etc.

Having observed 151 errors, pass the test at 2452+ samples, fail the test at 2433- samples, otherwise continue

Having observed 152 errors, pass the test at 2466+ samples, fail the test at 2451- samples.

Where  $x+$  means:  $x$  or more,  $x-$  means  $x$  or less

NOTE 1: an ideal DUT passes after 67 samples. The maximum test time is 2466 samples.

NOTE 2: It is allowed to deviate from the early decision concept by postponing the decision (pass/fail or continue). Postponing the decision to or beyond the end of Table H.2.4-1 requires a pass fail decision against the test limit: pass the DUT for  $ER < 0.0618$ , otherwise fail.

# Annex I:Void

## Annex J (normative): Test applicability per permitted test method

This annex describes, per test requirement, the permitted test methodologies as a function of DUT antenna configuration.

**Table J-1: Test metric applicability per permitted test method**

Test Metric	No DUT antenna configuration declaration	DUT antenna configuration declaration		
		Configuration 1 (one antenna panel with $D \leq 5$ cm active at any one time)	Configuration 2 (More than one antenna panel $D \leq 5$ cm without phase coherency between panels active at any one time)	Configuration 3 (Any phase coherent antenna panel of any size)
EIRP, TRP	IFF, Enhanced IFF, DFF+IFF (Note 1)	DFF, DFF simplification, IFF, Enhanced IFF, DFF+IFF (Note 2), NTF	DFF, DFF simplification, IFF, Enhanced IFF, DFF+IFF (Note 2), NTF	IFF, Enhanced IFF, DFF+IFF (Note 1)
EIS, Frequency Error, EVM, Carrier Leakage, In-Band Emission, EVM SF, OBW	IFF, Enhanced IFF, DFF+IFF (Note 1)	DFF, DFF simplification, IFF, Enhanced IFF, DFF+IFF (Note 2)	DFF, DFF simplification, IFF, Enhanced IFF, DFF+IFF (Note 2)	IFF, Enhanced IFF, DFF+IFF (Note 1)

NOTE: D = DUT radiating aperture declared by UE vendor.

Note 1: Only the IFF probe(s) are applicable

Note 2: Either DFF or IFF probe(s) are applicable

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## Annex K (normative): EIRP, TRP, and EIS measurement procedures

Annex K defines the EIRP, TRP, and EIS measurement procedures which includes Tx and Rx beam peak direction search, spherical coverage procedures and TRP procedures for the permitted testing methodologies defined in [5].

The default value for BEAM\_SELECT\_WAIT\_TIME = 3 sec for all applicable Tx and Rx test cases. The BEAM\_SELECT\_WAIT\_TIME represents a default minimum wait time period required to complete beam selection process at a single position before start of measurement. For a particular EUT, if it is known/determined that a lower wait time than default value is enough to complete beam selection process, then such a lower value may be used by the Test system to achieve test time optimization.

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### K.1 Direct far field (DFF)

#### K.1.1 TX beam peak direction search

This Tx beam peak search procedure applies to DUTs with and without support of *beamCorrespondenceWithoutUL-BeamSweeping*. The TX beam peak direction is found with a 3D EIRP scan (separately for each orthogonal downlink polarization). The TX beam peak direction search grid points for this single grid approach are defined in Annex M.2.1. Alternatively, a coarse and fine grid approach could be used according to the definition in Annex M.2.2.

The beam peak searches shall be performed for every test frequency range by default unless the device manufacturer explicitly declares that the beam peak at the mid test frequency range is applicable for the remaining (low, high) test frequency ranges. Beam peak search results cannot be re-used across different bands that do not overlap. Beam peak search results can be re-used from bands that completely contain the target bands if explicitly declared with a declaration.

A beam peak search shall be performed for every intra-band contiguous combination and CA BW class by default unless the device manufacturer explicitly declares that the beam peak for a reference (frequency band, CBW) or (frequency band combination, CA BW class) is applicable for a group of other intra-band contiguous combinations and CA BW classes.

The beam peak searches shall be performed for every modulation by default unless the device manufacturer explicitly declares that the beam peak at the QPSK modulation is applicable for the remaining 16QAM and 64QAM modulations.

The beam peak searches shall be performed for every waveform by default unless the device manufacturer explicitly declares that the beam peak from one waveform is applicable for the other waveform.

The beam peak searches shall be performed separately for NTC (Normal), ETC (TL), and ETC (TH).

The beam peak search results from single carrier can be re-used for UL MIMO testing.

The measurement procedure includes the following steps:

- 1) Select any of the three Alignment Options (1, 2, or 3) from Tables N.2-1 through N.2-7 [3] to mount the DUT inside the QZ.
- 2) Position the DUT in DUT Orientation 1 from Tables N.2-1 through N.2-7 [3].
- 3) Connect the SS (System Simulator) with the DUT through the measurement antenna with  $\text{Pol}_{\text{Link}}=\theta$  polarization to form the TX beam towards the measurement antenna. Allow at least BEAM\_SELECT\_WAIT\_TIME for the UE TX beam selection to complete.
- 4) Send continuously uplink power control "up" commands in every uplink scheduling information to the UE; allow at least 200 msec starting from the first TPC Command in this step for the UE to reach  $P_{\text{UMAX}}$  level. Allow at least BEAM\_SELECT\_WAIT\_TIME for the UE Tx beam selection to complete.
- 5) Through its beam correspondence procedure, DUT refines its TX beam toward that direction depending on DUT's beam correspondence capability which shall match OEM declaration:



- If the DUT's beam correspondence capability *beamCorrespondenceWithoutUL-BeamSweeping* is supported, then DUT autonomously chooses the corresponding TX beam for PUSCH transmission using downlink reference signals to transmit in the direction of the incoming DL signal, which is based on beam correspondence without relying on UL beam sweeping;
  - If the DUT's beam correspondence capability *beamCorrespondenceWithoutUL-BeamSweeping* is not present, then DUT chooses the TX beam for PUSCH transmission which is based on beam correspondence with relying on both DL measurements on downlink reference signals and network-assisted uplink beam sweeping (NOTE 3).
- 6) SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
  - 7) Measure the mean power  $P_{\text{meas}}(\text{Pol}_{\text{Meas}}=\theta, \text{Pol}_{\text{Link}}=\theta)$  of the modulated signal arriving at the power measurement equipment (such as a spectrum analyser, power meter, or gNB emulator).
  - 8) Calculate EIRP ( $\text{Pol}_{\text{Meas}}=\theta, \text{Pol}_{\text{Link}}=\theta$ ) by adding the composite loss of the entire transmission path for utilized signal path,  $L_{\text{EIRP},\theta}$ , and frequency to the measured power  $P_{\text{meas}}(\text{Pol}_{\text{Meas}}=\theta, \text{Pol}_{\text{Link}}=\theta)$ .
  - 9) Measure the mean power  $P_{\text{meas}}(\text{Pol}_{\text{Meas}}=\phi, \text{Pol}_{\text{Link}}=\theta)$  of the modulated signal arriving at the power measurement equipment.
  - 10) Calculate EIRP ( $\text{Pol}_{\text{Meas}}=\phi, \text{Pol}_{\text{Link}}=\theta$ ) by adding the composite losses of the entire transmission path for utilized signal path,  $L_{\text{EIRP},\phi}$ , and frequency to the measured power  $P_{\text{meas}}(\text{Pol}_{\text{Meas}}=\phi, \text{Pol}_{\text{Link}}=\theta)$ .
  - 11) Calculate total EIRP( $\text{Pol}_{\text{Link}}=\theta$ ) =  $\text{EIRP}(\text{Pol}_{\text{Meas}}=\theta, \text{Pol}_{\text{Link}}=\theta) + \text{EIRP}(\text{Pol}_{\text{Meas}}=\phi, \text{Pol}_{\text{Link}}=\theta)$ .
  - 12) SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.
  - 13) Connect the SS (System Simulator) with the DUT through the measurement antenna with  $\text{Pol}_{\text{Link}}=\phi$  polarization to form the TX beam towards the measurement antenna. Allow at least BEAM\_SELECT\_WAIT\_TIME for the UE TX beam selection to complete.
  - 14) Repeat steps 4 through 12 and get the result of total EIRP( $\text{Pol}_{\text{Link}}=\phi$ ) =  $\text{EIRP}(\text{Pol}_{\text{Meas}}=\theta, \text{Pol}_{\text{Link}}=\phi) + \text{EIRP}(\text{Pol}_{\text{Meas}}=\phi, \text{Pol}_{\text{Link}}=\phi)$
  - 15) Advance to the next grid point and repeat steps 3 through 14 until measurements within zenith range  $0^\circ \leq \theta \leq 90^\circ$  have been completed
  - 16) After the measurements within zenith range  $0^\circ \leq \theta \leq 90^\circ$  have been completed and
    - a) if the re-positioning concept is applied to the TX test cases, position the device in DUT Orientation 2 (either Options 1 or 2) from Tables N.2-1 through N.2-7 [3] for the Alignment Option selected in Step 1. For the TX beam peak search in the second hemisphere, perform steps 3 through 15 for the range of zenith angles  $90^\circ > \theta \geq 0^\circ$ .
    - b) if the re-positioning concept is not applied to the TX test cases, continue steps 3 through 15 for the range of zenith angles  $90^\circ < \theta \leq 180^\circ$

If the beam correspondence capability *beamCorrespondenceWithoutUL-BeamSweeping* is not present, the above step 5) can be further clarified as following sub-steps:

- 5.1) DUT uses downlink reference signals to select proper RX beam and uses autonomous beam correspondence to select the TX beam.
- 5.2) SS configures  $M=8$  SRS resources to DUT, with the field *spatialRelationInfo* omitted and the field *usage* set as 'beamManagement'. In case DUT supports less than 8 SRS resources, SS configures the number of SRS resources according to the maximum number of SRS resources indicated by UE capability signalling. Additionally, for codebook based PUSCH transmission, SS configures a semi-persistent SRS resource set with the field *usage* as 'codebook'.
- 5.3) Based on the TX beam autonomously selected by DUT, DUT chooses TX beams to transmit SRS-resources configured by SS.

5.4) Based on measurement of the received *beamManagement* SRS, SS chooses the best SRS beam and, if needed, updates the spatial relation information between the semi-persistent *codebook* SRS resources and the SS selected *beamManagement* SRS resource in the activation MAC CE of the semi-persistent SRS resource. The SS indicates in the SRS Resource Indicator (SRI) field in the scheduling grant for PUSCH, if present, the SRS resource within the semi-persistent SRS resource set whose spatial relation is linked to the best detected SRS beam.

5.5) DUT transmits PUSCH corresponding to the SRS resource indicated by the SRI.

The TX beam peak direction is where the maximum total component of  $EIRP(Pol_{Link}=\theta)$  or  $EIRP(Pol_{Link}=\phi)$  is found. Whenever this TX beam peak direction is used, if the UE does not support *beamCorrespondenceWithoutUL-BeamSweeping*, the side conditions for SSB-based and CSI-RS based L1-RSRP measurements are applied as per Table 6.6.1.3.3.1.1-1 and Table 6.6.1.3.3.1.1-2 respectively just before setting TX beam peak direction.

NOTE 1: Void.

NOTE 2: VOID.

NOTE 3:

In order to allow the UE to carry out its Rel 15 beam correspondence procedure, the side conditions for SSB based and CSI-RS based L1-RSRP measurements are configured as per Table 6.6.1.3.3.1.1-1 and Table 6.6.1.3.3.1.1-2 respectively.

For Release 16 and forward UEs: unless otherwise stated within the test case, the following side conditions are applied for the enhanced beam correspondence procedure, depending on the UE capability

- a. If *beamCorrespondenceWithoutUL-BeamSweeping* is NOT supported and *beamCorrespondenceSSB-based-r16* is supported: use side conditions defined in Table 6.6.1.3.3.1.1-1
- b. If *beamCorrespondenceWithoutUL-BeamSweeping* is NOT supported, and *beamCorrespondenceCSI-RS-based-r16* is supported: use side conditions defined in Table 6.6.2.3.3-1
- c. If *beamCorrespondenceWithoutUL-BeamSweeping* is NOT supported and *beamCorrespondenceSSB-based-r16* and *beamCorrespondenceCSI-RS-based-r16* are supported: use side conditions defined in Table 6.6.1.3.3.1.1-1.
- d. If *beamCorrespondenceWithoutUL-BeamSweeping* is NOT supported and *beamCorrespondenceSSB-based-r16* and *beamCorrespondenceCSI-RS-based-r16* are NOT supported: use side conditions defined in Table 6.6.1.3.3.1.1-1 and Table 6.6.1.3.3.1.1-2.
- e. If *beamCorrespondenceWithoutUL-BeamSweeping* is supported and *beamCorrespondenceSSB-based-r16* is supported: use side conditions defined in Table 6.6.1.3.3.1.1-1
- f. If *beamCorrespondenceWithoutUL-BeamSweeping* is supported, and *beamCorrespondenceCSI-RS-based-r16* is supported: use side conditions defined in Table 6.6.2.3.3-1
- g. If *beamCorrespondenceWithoutUL-BeamSweeping* is supported and *beamCorrespondenceSSB-based-r16* and *beamCorrespondenceCSI-RS-based-r16* are supported: use side conditions defined in Table 6.6.1.3.3.1.1-1.
- h. If *beamCorrespondenceWithoutUL-BeamSweeping* is supported and *beamCorrespondenceSSB-based-r16* and *beamCorrespondenceCSI-RS-based-r16* are NOT supported: use side conditions defined in Table 6.6.1.3.3.1.1-1 and Table 6.6.1.3.3.1.1-2.

## K.1.2 RX beam peak direction search

Editor's note: The following aspects are either missing or not yet determined:

- The Rx beam peak direction search for intra-band DL CA configurations with frequency separations larger than 800 MHz is currently FFS.

The RX beam peak direction is found with a 3D EIS scan (separately for each orthogonal downlink polarization). The RX beam peak direction search grid points for this single grid approach are defined in Annex M.2.1. Alternatively, a coarse and fine grid approach could be used according to the definition in Annex M.2.4.

The beam peak searches shall be performed for every test frequency range by default unless the device manufacturer explicitly declares that the beam peak at the mid test frequency range is applicable for the remaining (low, high) test frequency ranges. Beam peak search results cannot be re-used across different bands that do not overlap. Beam peak search results can be re-used from bands that completely contain the target bands if explicitly declared with a declaration.

A beam peak search shall be performed for every intra-band contiguous combination and CA BW class by default unless the device manufacturer explicitly declares that the beam peak for a reference (frequency band, CBW) or (frequency band combination, CA BW class) is applicable for a group of other intra-band contiguous combinations and CA BW classes.

The beam peak searches shall be performed for every modulation by default unless the device manufacturer explicitly declares that the beam peak at the QPSK modulation is applicable for the remaining 16QAM and 64QAM modulations.

The beam peak searches shall be performed separately for NTC (Normal), ETC (TL), and ETC (TH).

The single carrier measurement procedure includes the following steps:

- 1) Select any of the three Alignment Options (1, 2, or 3) from Tables N.2-1 through N.2-7 [3] to mount the DUT inside the QZ.
- 2) Position the DUT in DUT Orientation 1 from Tables N.2-1 through N.2-7 [3].
- 3) Connect the SS (System Simulator) with the DUT through the measurement antenna with  $\text{Pol}_{\text{Link}}=\theta$  polarization to form the RX beam towards the DUT. Allow at least BEAM\_SELECT\_WAIT\_TIME for the UE RX beam selection to complete.
- 4) Determine  $\text{EIS}(\text{Pol}_{\text{Meas}}=\theta, \text{Pol}_{\text{Link}}=\theta)$  for  $\theta$ -polarization, i.e., by sweeping the power level for the  $\theta$ -polarization, at which the throughput exceeds the requirements for the specified reference measurement channel. The downlink power step size shall be no more than 0.2 dB when the RF power level is near the sensitivity level (coarse and fine searches are not precluded as long as the fine search is using the 0.2dB step size near the sensitivity level).
- 5) Connect the SS (System Simulator) with the DUT through the measurement antenna with  $\text{Pol}_{\text{Link}}=\phi$  polarization to form the RX beam towards the DUT. Allow at least BEAM\_SELECT\_WAIT\_TIME for the UE RX beam selection to complete.
- 6) Determine  $\text{EIS}(\text{Pol}_{\text{Meas}}=\phi, \text{Pol}_{\text{Link}}=\phi)$  for  $\phi$ -polarization, i.e., by sweeping the power level for the  $\phi$ -polarization, at which the throughput exceeds the requirements for the specified reference measurement channel. The downlink power step size shall be no more than 0.2 dB when the RF power level is near the sensitivity level (coarse and fine searches are not precluded as long as the fine search is using the 0.2dB step size near the sensitivity level).
- 7) Advance to the next grid point and repeat steps 3 through 6 until measurements within zenith range  $0^\circ \leq \theta \leq 90^\circ$  have been completed
- 8) After the measurements within zenith range  $0^\circ \leq \theta \leq 90^\circ$  have been completed and
  - a) if the re-positioning concept is applied to the RX test cases, position the device in DUT Orientation 2 (either Options 1 or 2) from Tables N.2-1 through N.2-7 [3] for the Alignment Option selected in Step 1. For the RX beam peak search in the second hemisphere, perform steps 3 through 6 for the range of zenith angles  $90^\circ > \theta \geq 0^\circ$ .
  - b) If the re-positioning concept is not applied to the RX test cases, continue steps 3 through 6 for the range of zenith angles  $90^\circ < \theta \leq 180^\circ$
- 9) Calculate the resulting “averaged EIS” as:

$$\text{averaged EIS} = 2 * [1/\text{EIS}(\text{Pol}_{\text{Meas}}=\theta, \text{Pol}_{\text{Link}}=\theta) + 1/\text{EIS}(\text{Pol}_{\text{Meas}}=\phi, \text{Pol}_{\text{Link}}=\phi)]^{-1}$$

The RX beam peak direction is where the minimum “averaged EIS” is found.

Alternatively, the RX beam peak direction for single carrier could be determined following the procedure described in Annex K.1.11.

For intra-band DL CA configurations with a frequency separation up to 800 MHz, if for single carrier test the Rx beam peak direction has been found for any frequency within the CA bandwidth, such direction shall be used. Otherwise, the single carrier measurement procedure is performed only on the PCC and the RX beam peak direction for the DL CA configuration is the direction of the PCC Rx beam peak direction.

For intra-band DL CA configurations with a frequency separation up to 800 MHz, if UE vendor provides a Beam Peak Search Declaration with respect to test frequency range for single CC for a given band, see 38.508-2 [4] table A.4.3.9-5, such declaration will also apply to PCC in DL CA configurations for that band.

For intra-band DL CA configurations with a frequency separation larger than 800 MHz the beam peak direction search procedure is FFS.

### K.1.3 Peak EIRP measurement procedure

This section describes EIRP measurement procedure for a chosen  $\text{Pol}_{\text{Link}}$  of  $\theta$  or  $\phi$

The TX beam peak direction is where the maximum total component of EIRP is found, including the respective polarization of the measurement antenna used to form the TX beam, according to K.1.1.

The measurement procedure includes the following steps:

- 1) Select any of the three Alignment Options (1, 2, or 3) from Tables N.2-1 through N.2-7 [3] to mount the DUT inside the QZ.
- 2) If the re-positioning concept is not applied to the TX test cases, position the device in DUT Orientation 1. If the re-positioning concept is applied to the TX test cases,
  - a) position the device in DUT Orientation 1 from Tables N.2-1 through N.2-7 [3] if the maximum beam peak direction is within zenith angular range  $0^\circ \leq \theta \leq 90^\circ$  for the alignment option selected in step 1
  - b) position the device in DUT Orientation 2 (either Options 1 or 2) from Tables N.2-1 through N.2-7 [3] if the maximum beam peak direction is within zenith angular range  $90^\circ < \theta \leq 180^\circ$  for DUT Orientation 1 for the alignment option selected in step 1.
- 3) Connect the SS (System Simulator) with the DUT through the measurement antenna with polarization reference  $\text{Pol}_{\text{Link}}$  to form the TX beam towards the TX beam peak direction and respective polarization. Allow at least BEAM\_SELECT\_WAIT\_TIME for the UE TX beam selection to complete.
- 4) SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
- 5) Measure the mean power  $P_{\text{meas}}(\text{Pol}_{\text{Meas}}=\theta, \text{Pol}_{\text{Link}})$  of the modulated signal arriving at the power measurement equipment (such as a spectrum analyser, power meter, or gNB emulator).
- 6) Calculate  $\text{EIRP}(\text{Pol}_{\text{Meas}}=\theta, \text{Pol}_{\text{Link}})$  by adding the composite loss of the entire transmission path for utilized signal path,  $L_{\text{EIRP},\theta}$ , and frequency to the measured power  $P_{\text{meas}}(\text{Pol}_{\text{Meas}}=\theta, \text{Pol}_{\text{Link}})$ .
- 7) Measure the mean power  $P_{\text{meas}}(\text{Pol}_{\text{Meas}}=\phi, \text{Pol}_{\text{Link}})$  of the modulated signal arriving at the power measurement equipment.
- 8) Calculate  $\text{EIRP}(\text{Pol}_{\text{Meas}}=\phi, \text{Pol}_{\text{Link}})$  by adding the composite losses of the entire transmission path for utilized signal path,  $L_{\text{EIRP},\phi}$  and frequency to the measured power  $P_{\text{meas}}(\text{Pol}_{\text{Meas}}=\phi, \text{Pol}_{\text{Link}})$
- 9) Calculate the resulting “total EIRP( $\text{Pol}_{\text{Link}}$ )”, for the chosen  $\text{Pol}_{\text{Link}}$  of  $\theta$  or  $\phi$  as follows:

$$\text{total EIRP}(\text{Pol}_{\text{Link}}) = \text{EIRP}(\text{Pol}_{\text{Meas}}=\theta, \text{Pol}_{\text{Link}}) + \text{EIRP}(\text{Pol}_{\text{Meas}}=\phi, \text{Pol}_{\text{Link}})$$

- 10) SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

## K.1.4 Peak EIS measurement procedure

This section describes EIS measurement procedure. The RX beam peak direction is where the minimum EIS is found according to K.1.2.

The measurement procedure includes the following steps:

- 1) Select any of the three Alignment Options (1, 2, or 3) from Tables N.2-1 through N.2-7 [3] to mount the DUT inside the QZ.
- 2) If the re-positioning concept is not applied to the RX test cases, position the device in DUT Orientation 1. If the re-positioning concept is applied to the RX test cases
  - a) position the device in DUT Orientation 1 from Tables N.2-1 through N.2-7 [3] if the maximum beam peak direction is within zenith angular range  $0^\circ \leq \theta \leq 90^\circ$  for the alignment option selected in step 1
  - b) position the device in DUT Orientation 2 (either Options 1 or 2) from Tables N.2-1 through N.2-7 [3] if the maximum beam peak direction is within zenith angular range  $90^\circ < \theta \leq 180^\circ$  for DUT Orientation 1 for the alignment option selected in step 1.
- 3) Connect the SS (System Simulator) with the DUT through the measurement antenna with  $\text{Pol}_{\text{Link}}=\theta$  polarization to form the RX beam towards the RX beam peak direction. Allow at least BEAM\_SELECT\_WAIT\_TIME for the UE RX beam selection to complete.
- 4) Determine  $\text{EIS}(\text{Pol}_{\text{Meas}}=\theta, \text{Pol}_{\text{Link}}=\theta)$  for  $\theta$ -polarization, i.e., the power level for the  $\theta$ -polarization at which the throughput exceeds the requirements for the specified reference measurement channel. The downlink power step size shall be no more than 0.2 dB when the RF power level is near the sensitivity level.
- 5) Connect the SS (System Simulator) with the DUT through the measurement antenna with  $\text{Pol}_{\text{Link}}=\phi$  polarization to form the RX beam towards the RX beam peak direction. Allow at least BEAM\_SELECT\_WAIT\_TIME for the UE RX beam selection to complete.
- 6) Determine  $\text{EIS}(\text{Pol}_{\text{Meas}}=\phi, \text{Pol}_{\text{Link}}=\phi)$  for  $\phi$ -polarization, i.e., the power level for the  $\phi$ -polarization at which the throughput exceeds the requirements for the specified reference measurement channel. The downlink power step size shall be no more than 0.2 dB when the RF power level is near the sensitivity level.
- 7) Calculate the resulting averaged EIS as:

$$\text{EIS} = 2 * [1/\text{EIS}(\text{Pol}_{\text{Meas}}=\theta, \text{Pol}_{\text{Link}}=\theta) + 1/\text{EIS}(\text{Pol}_{\text{Meas}}=\phi, \text{Pol}_{\text{Link}}=\phi)]^{-1}$$

## K.1.5 EIRP spherical coverage

The EIRP results from the TX beam peak search procedures of K.1.1, using the minimum number of grid points as described in Annex M.2.1 can be re-used for EIRP spherical coverage.

In case a coarse beam peak grid is used for TX beam peak search, using the minimum number of grid points defined in Annex M.3.1.1, the EIRP results can be re-used for EIRP spherical coverage.

### K.1.5.0 Tx Spherical Coverage Method

In case a separate test is performed for EIRP spherical coverage, the procedure as per K.1.3 should be followed using the minimum number of grid points defined in Annex M.3.1.1 for spherical coverage.

The  $\text{EIRP}_{\text{target-CDF}}$  is then obtained from the Cumulative Distribution Function (CDF) computed using  $\text{maximum}(\text{EIRP}(\text{Pol}_{\text{Link}}=\theta), \text{EIRP}(\text{Pol}_{\text{Link}}=\phi))$  for all grid points. When using constant step size measurement grids, a theta-dependent correction shall be applied, i.e., the PDF probability contribution for each measurement point is scaled by  $\sin(\theta)$  or the normalized Clenshaw-Curtis weights  $W(\theta)/W(90^\circ)$ , introduced in Section M.4.2.1, to account for the denser grid point distribution near the poles. In case of Clenshaw-Curtis weights, when just a single measurement at the poles is performed, the PDF probability contributions need to be scaled by  $M * W(\theta)/W(\theta=90^\circ)$  to account for the M longitudes at those two grid points. When using constant density grids, these corrections are not needed.

## K.1.5.1 Tx Fast Spherical Coverage Method

### K.1.5.1.1 Introduction

The Fast Spherical Coverage Method is a test method providing an optimized test time for Tx spherical coverage measurements. This method is applicable to constant density and constant step size grid type. Instead of measuring all grid points as per Annex M, as required by the test procedure defined in Annex K.1.5, this method requires only a reduced number of grid points to be measured.

### K.1.5.1.2 Description

To use this method, apply the following steps

- 1) During the EIRP Spherical coverage measurements, calculate the EIRP result for the grid point as  $EIRP_{spherical} = \text{Max}(EIRP(\text{Pol}_{Link} = \theta), EIRP(\text{Pol}_{Link} = \phi))$  starting with  $N_{grid, meas, PASS} = 0$ . If the  $EIRP_{spherical}$  value is above the Min EIRP spherical coverage limit increase  $N_{grid, meas, PASS}$  by 1.
- 2) Calculate the percentage of total grid points measured thus far above the EIRP spherical coverage requirement limit  $N_{grid, meas, PASS}$  compared to the total number of grid points on the measurement grid  $N_{grid, total}$ .
- 3) If the percentage calculated in step 2) is equal to or higher than  $(100 - n^{\text{th}} \text{ percentile for EIRP spherical coverage})\%$ , pass the device, otherwise continue to step 4. If all grid points have been measured, calculate the CDF for all grid points and pass the UE if the derived %-tile EIRP in measurement distribution exceeds the requirement. Otherwise fail the UE.
- 4) Advance to the next grid point and repeat the steps until measurements within zenith range  $0^\circ \leq \theta \leq [90]^\circ$  have been completed

NOTE 1: For test systems where the device repositioning approach outlined in Annex N is applied, the grid points of up to a zenith of  $[90]^\circ$  are allowed to be measured in the first hemisphere before the device needs to be placed in the second orientation.

### K.1.5.1.3 Measurement uncertainties

Same as when test procedure described in clause K.1.5.0 is used.

## K.1.6 EIS spherical coverage

The EIS results from the RX beam peak search procedures of K.1.2, using the minimum number of grid points as described in Annex M.2.2 can be re-used for EIS spherical coverage.

In case a coarse beam peak grid is used for RX beam peak search with an EIS metric, using the minimum number of grid points defined in Annex M.3.2.1, the EIS results can be re-used for EIS spherical coverage.

### K.1.6.0 Rx Spherical Coverage Method

In case a separate test is performed for spherical coverage, the procedure K.1.4 should be followed using the minimum number of grid points defined in Annex M.3.2.1 for spherical coverage.

The  $EIS_{\text{target-CDF}}$  is then obtained from the Cumulative Distribution Function (CDF) computed using averaged EIS for all grid points. When using constant step size measurement grids, a theta-dependent correction shall be applied, i.e., the PDF probability contribution for each measurement point is scaled by  $\sin(\theta)$  or the normalized Clenshaw-Curtis weights  $W(\theta)/W(90^\circ)$ , introduced in Section M.4.2.1, to account for the denser grid point distribution near the poles. In case of Clenshaw-Curtis weights, when just a single measurement at the poles is performed, the PDF probability contributions need to be scaled by  $M \cdot W(\theta)/W(\theta=90^\circ)$  to account for the M longitudes at those two grid points. When using constant density grids, these corrections are not needed.

## K.1.6.1 Rx Fast Spherical Coverage Method

### K.1.6.1.1 Introduction

Same as Annex K.1.5.1.2 except that this sub-clause is applicable to Rx measurements in Annex K.1.6.

### K.1.6.1.2 Description

To use this method, apply the following steps

- 1) During the EIS Spherical coverage measurements, calculate the averaged EIS as:  $EIS = 2 * [1/EIS(Pol_{Meas} = \theta, Pol_{Link} = \theta) + 1/EIS(Pol_{Meas} = \phi, Pol_{Link} = \phi)]^{-1}$  at each grid point starting with  $N_{grid, meas, PASS} = 0$ . If the EIS value is below the EIS spherical coverage limit increase  $N_{grid, meas, PASS}$  by 1.
- 2) Calculate the percentage of total grid points measured thus far above the EIS spherical coverage requirement limit  $N_{grid, meas, PASS}$  compared to the total number of grid points on the measurement grid  $N_{grid, total}$ .
- 3) If the percentage calculated in step 2) is equal to or higher than (100 - n<sup>th</sup> percentile for EIS spherical coverage)%, pass the device, otherwise continue to step 4. If all grid points have been measured, calculate the CDF for all grid points and pass the UE if the derived %-tile EIRP in measurement distribution exceeds the requirement. Otherwise fail the UE.
- 4) Advance to the next grid point and repeat the steps until measurements within zenith range  $0^\circ \leq \theta \leq 90^\circ$  have been completed.

NOTE 1: Same as NOTE 1 in Annex K.1.5.1.2.

### K.1.6.1.3 Measurement uncertainties

Same as when test procedure described in clause K.1.6.0 is used.

## K.1.7 TRP measurement procedure

The minimum number of measurement points for TRP measurement grid is outlined in Annex M.4.

The measurement procedure includes the following steps:

- 1) Select any of the three Alignment Options (1, 2, or 3) from Tables N.2-1 through N.2-7 [3] to mount the DUT inside the QZ.
- 2) If the re-positioning concept is not applied to the TX test cases, position the device in DUT Orientation 1. If the re-positioning concept is applied to the TX test cases
  - a) position the device in DUT Orientation 1 from Tables N.2-1 through N.2-7 [3] if the maximum beam peak direction is within zenith angular range  $0^\circ \leq \theta \leq 90^\circ$  for the alignment option selected in step 1
  - b) Position de device in DUT Orientation 2 (either Options 1 or 2) from Tables N.2-1 through N.2-7 [3] if the maximum beam peak direction is within zenith angular range  $90^\circ < \theta \leq 180^\circ$  for DUT Orientation 1 for the alignment option selected in step 1.
- 3) Connect the SS with the DUT through the measurement antenna with desired polarization reference  $Pol_{Link}$  to form the TX beam towards the desired TX beam direction and respective polarization. Allow at least BEAM\_SELECT\_WAIT\_TIME for the UE TX beam selection to complete.
- 4) SS activates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.2 using condition Tx only.
- 5) For each measurement grid point, measure  $P_{meas}(Pol_{Meas} = \theta, Pol_{Link})$  and  $P_{meas}(Pol_{Meas} = \phi, Pol_{Link})$ . The angle between the measurement antenna and the DUT ( $\theta_{Meas}, \phi_{Meas}$ ) is achieved by rotating the measurement antenna and the DUT (based on system architecture).

- 6) Calculate  $EIRP(Pol_{Meas}=\theta, Pol_{Link})$  and  $EIRP(Pol_{Meas}=\phi, Pol_{Link})$  by adding the composite loss of the entire transmission path for utilized signal paths,  $L_{EIRP,\theta}$ ,  $L_{EIRP,\phi}$  and frequency to the respective measured powers  $P_{meas}$ .
- 7) The TRP value for the uniform measurement grid is calculated using the TRP integration approaches outlined in Annex M.4.2. The TRP value for the constant density grid is calculated using the TRP integration formula in Annex M.4.3.
- 8) SS deactivates the UE Beamlock Function (UBF) by performing the procedure as specified in TS 38.508-1 [10] clause 4.9.3.

## K.1.8 Blocking measurement procedure

The RX beam peak direction is where the minimum EIS is found according to K.1.2.

The measurement procedure includes the following steps:

- 1) Select any of the three Alignment Options (1, 2, or 3) from Tables N.2-1 through N.2-7 to mount the DUT inside the QZ.
- 2) If the re-positioning concept is not applied to the RX test cases, position the device in DUT Orientation 1. If the re-positioning concept is applied to the RX test cases
  - a) position the device in DUT Orientation 1 from Tables N.2-1 through N.2-7 [3] if the maximum beam peak direction is within zenith angular range  $0^\circ \leq \theta \leq 90^\circ$  for the alignment option selected in step 1
  - b) position the device in DUT Orientation 2 (either Options 1 or 2) from Tables N.2-1 through N.2-7 [3] if the maximum beam peak direction is within zenith angular range  $90^\circ < \theta \leq 180^\circ$  for DUT Orientation 1 for the alignment option selected in step 1.
- 3) Establish a connection between the DUT and the SS with the downlink signal applied to the  $\theta$ -polarization of the measurement antenna
- 4) Position the UE so that the beam is formed towards the measurement antenna in the RX beam peak direction.
- 5) Apply a signal with the specified reference measurement channel on the  $\theta$ -polarization, setting the power level of the signal 3dB below the EIS level stated in the requirement.
- 6) Apply the blocking signal with the same polarization and coming from the same direction as the downlink signal. Set the power level of the blocking signal 3dB below the level stated in the requirement.
- 7) Measure the throughput of the downlink signal on the  $\theta$ -polarization.
- 8) Switch the downlink and blocking signal to the  $\phi$ -polarization of the measurement antenna.
- 9) Repeat steps 3 to 7 on the  $\phi$ -polarization.
- 10) Compare the results for both the  $\theta$ -polarization and  $\phi$ -polarization against the requirement. If both results meet the requirements, pass the UE.

## K.1.9 Beam Correspondence tolerance procedure

This beam correspondence tolerance procedure applies to the DUT with beam correspondence capability *beamCorrespondenceWithoutUL-BeamSweeping* not present (which shall match OEM declaration), such that DUT relies on uplink beam sweeping to fulfil the minimum peak EIRP and spherical coverage requirements.

The measurement procedure includes the following steps for each of the points in the grid:

- 1) Follow the test procedures specified in subclause K.1.5 with uplink beam sweeping disabled, obtain total  $EIRP_1(Pol_{Link}=\theta)$  and total  $EIRP_1(Pol_{Link}=\phi)$ .  $EIRP_1$  is calculated by  $EIRP_1 = \text{maximum}(EIRP_1(Pol_{Link}=\theta), EIRP_1(Pol_{Link}=\phi))$ .



- 2) Follow the test procedures specified in subclause K.1.5, with uplink beam sweeping enabled (SS does not configure the *spatialRelationInfo* to DUT) during DUT TX beam refinement, obtain total EIRP<sub>2</sub>(Pol<sub>Link</sub>=θ) and total EIRP<sub>2</sub>(Pol<sub>Link</sub>=φ). EIRP<sub>2</sub> is calculated by EIRP<sub>2</sub> = maximum(EIRP<sub>2</sub>(Pol<sub>Link</sub>=θ), EIRP<sub>2</sub>(Pol<sub>Link</sub>=φ)).
- 3) Calculate the  $\Delta\text{EIRP}_{\text{BC}} = \text{EIRP}_2 - \text{EIRP}_1$ .

The  $\Delta\text{EIRP}_{\text{target-CDF}}$  is then obtained from the Cumulative Distribution Function (CDF) computed using  $\Delta\text{EIRP}_{\text{BC}}$  for each of all top N<sup>th</sup> percentile of the EIRP<sub>2</sub> measurement points in the grid. When using constant step size measurement grids, a theta-dependent correction shall be applied, i.e., the PDF probability contribution for each measurement point is scaled by sin(θ) or the normalized Clenshaw-Curtis weights W(θ)/W(90°), introduced in Section M.4.2.1.

NOTE:  $\Delta\text{EIRP}_{\text{BC}}$  is introduced for beam correspondence tolerance based on two EIRP measurements (EIRP<sub>1</sub> and EIRP<sub>2</sub>). EIRP<sub>1</sub> is the measured total EIRP based on the beam which DUT chooses autonomously (corresponding beam) to transmit in the direction of the incoming DL signal, which is based on beam correspondence without relying on UL beam sweeping. EIRP<sub>2</sub> is the measured total EIRP based on the beam yielding highest EIRP in a given direction, which is based on beam correspondence with relying on UL beam sweeping.  $\Delta\text{EIRP}_{\text{BC}}$  shall be calculated over the link angles spanning a subset of the spherical coverage grid points which are corresponding to the top N<sup>th</sup> percentile of the EIRP<sub>2</sub> measurement points in the grid, where the value of N is according to EIRP spherical coverage requirement of DUT's power class defined in TS 38.101-2 [3] clause 6.2.1, e.g., N=50 for power class 3 DUT.

## K.1.11 RSRP(B) based RX beam peak search

**Editor's Note:** This clause is incomplete. The following aspects are not determined.

- Feasibility and Applicability of this RSRP-B based Rx beam peak search is FFS
- Additional analysis of side conditions to be applied is FFS
- Analysis of MU impact is FFS
- Additional optimization of the method for use in scenarios such as Carrier Aggregation and EN-DC is still FFS

RSRP(B)-based RX beam peak search approach is applicable to find the beam peak, the beam peak search time can be reduced significantly.

### K.1.11.1 Test procedure

The RX beam peak direction is found with a 3D RSRP(B) scan (separately for each orthogonal downlink polarization). The RX beam peak direction is where the maximum total component of RSRP is found. The RX beam peak direction search grid points for this single grid approach are defined in Annex M,2.

The measurement procedure includes the following steps:

- 1) Select any of the three Alignment Options (1, 2, or 3) from Tables N.2-1 through N.2-3 [3] to mount the DUT inside the QZ.
- 2) Position the DUT in DUT Orientation 1 or 2 from Tables N.2-1 through N.2-3 [3].
- 3) Connect the SS (System Simulator) with the DUT through the measurement antenna with Pol<sub>Link</sub>=θ polarization to form the RX beam towards the measurement antenna.
- 4) Adjust the DL power of the SS to obtain the NR DL signal level as per Table C.0-1 at the centre of QZ. Determine RSRP or RSRPBs (one per receiver branch) at Pol<sub>Meas</sub>=Pol<sub>Link</sub>=θ condition reported by UE.
- 5) Connect the SS (System Simulator) with the DUT through the measurement antenna with Pol<sub>Link</sub>=φ polarization to form the RX beam towards the measurement antenna.
- 6) Set the same DL power as the one in step 4. Determine RSRP or RSRPBs (one per receiver branch) at Pol<sub>Meas</sub>=Pol<sub>Link</sub>=φ condition reported by UE.
- 7) Advance to the next grid point and repeat steps 3 through 6 until measurements within the full 3D scan have been completed.

8) Data processing the linear sum of four reported RSRPBs. How to calculate the reported RSRPs is FFS.

To guarantee RSRP(B) accuracy, SNR side condition configuration can refer to the minimum SSB\_RP specified for beam correspondence defined in Table K.1.11-1 (from TS 38.101-2 [3] Table 6.6.4.3.1-1):

**Table K.1.11.1-1: Conditions for SSB based L1-RSRP measurements for beam correspondence**

Angle of arrival	NR operating bands	Minimum SSB_RP <sup>Note 2</sup>		SSB $\hat{E}_s/\text{lot}$ dB
		dBm / SCS <sub>SSB</sub>		
		SCS <sub>SSB</sub> = 120 kHz		
All angles <sup>Note 1</sup>	n257	-96.2		≥6
	n258	-96.2		
	n259	-90.7		
	n260	-91.9		
	n261	-96.2		
	n262	-88.5		
NOTE 1: For UEs that support multiple FR2 bands, the Minimum SSB_RP values for all angles are increased by $\Delta\text{MB}_{S,n}$ , the UE multi-band relaxation factor in dB specified in clause 6.2.1.				
NOTE 2: Values specified at the radiated requirements reference point to give minimum SSB $\hat{E}_s/\text{lot}$ , with no applied noise.				

### K.1.12 Enhanced test method for EIRP measurements

*Editor’s Note: This clause is incomplete. The following aspects are not determined.*

- *Applicability of this enhanced method is FFS*
- *Additional analysis of how this method can be used within existing tests is FFS*
- *Additional optimization of the method for use in scenarios such as Carrier Aggregation and EN-DC is still FFS*

Transmitted Matrix Precoding Indicator (TPMI) is the basis of codebook based transmission enabling multi-port antenna transmission. TPMI method is identified as applicable method to enhance EIRP measurement, which is able to activate dual polarization transmission in EIRP measurement. The applicability of this method is defined in Clause K.1.12.1.

For FR2 UEs support the TPMI method, the precoding matrix  $W$  is given by Table K.1.12-1 (same as Table 6.3.1.5-1 in TS 38.211 [9]). 2Tx TPMI index 2-5 can force UE single-layer transmission using two antenna ports. Among them, only TPMI index 2 is selected for EIRP measurement.

**Table K.1.12-1-1: Precoding matrix  $W$  for single-layer transmission using two antenna ports**

TPMI index	$W$ (ordered from left to right in increasing order of TPMI index)							
	0 – 5	$\frac{1}{\sqrt{2}} \begin{bmatrix} 1 \\ 0 \end{bmatrix}$	$\frac{1}{\sqrt{2}} \begin{bmatrix} 0 \\ 1 \end{bmatrix}$	$\frac{1}{\sqrt{2}} \begin{bmatrix} 1 \\ 1 \end{bmatrix}$	$\frac{1}{\sqrt{2}} \begin{bmatrix} 1 \\ -1 \end{bmatrix}$	$\frac{1}{\sqrt{2}} \begin{bmatrix} 1 \\ j \end{bmatrix}$	$\frac{1}{\sqrt{2}} \begin{bmatrix} 1 \\ -j \end{bmatrix}$	-

The permitted test methods (i.e. DFF, IFF and NFTF) in [5] are all applicable for TPMI method with the additional procedure that the UE should be configured with TPMI index and working at single-layer transmission using two antenna ports, before performing EIRP-based test procedures in Clause 5.2.1.3 in TR38.810 [5].:

- Peak EIRP Measurement Procedure
- TRP Measurement Procedure
- TX Beam Peak direction search and EIRP Spherical Coverage

### K.1.12.1 Applicability of TPMI side condition method

TPMI is applicable for one layer transmission with multi-port antenna. In FR2, dual polarization can be regarded as dual antenna ports, so it is natural to activate dual polarization transmission with TPMI side condition in EIRP measurement procedure. However, for TPMI supporting dual antenna ports, the number of SRS ports (*nrofSRS-Ports*) is configured as 2 for both one layer transmission with 'full power transmission' and two layers transmission with regular UL MIMO, as specified in clause 6.1 of TS 38.101-2 [3]:

For a UE that supports 'UL full power transmission' and is configured to transmit a single layer with *nrofSRS-Ports* = 2, the requirements for UL MIMO operation apply only when it is configured for any of its declared full power modes in IE *FullPowerTransmission-r16* (as defined in TS 38.331[19]).

For a UE configured to transmit 2 layers, transmitter requirements for UL MIMO operation apply when the UE transmits on 2 ports on the same CDM group. The UE may use higher MPR values outside this limitation.

Thus, TPMI method is applicable for the following FR2 UEs:

- Rel-15 Coherent UE (UE capability *pusch-TransCoherence* = *fullCoherent* with network configuration *codebookSubset*= *FullyAndPartialAndNonCoherent*).
- Rel-16 and onwards Coherent UE (UE capability *pusch-TransCoherence* = *fullCoherent* with network configuration *codebookSubset*= *FullyAndPartialAndNonCoherent*).
- Rel-16 and onwards UE supporting UL full power transmission mode1 (UE capability *ul-FullPwrMode1-r16*= *supported* with network configuration *ul-FullPowerTransmission* = *fullpowerMode1*).

Other UEs are not applicable for TPMI based test method.

### K.1.12.2 TPMI side condition method Measurement uncertainties impact

TPMI side condition method has no impact on measurement uncertainties.

## K.2 Direct far field (DFF) simplification

### K.2.1 TX beam peak direction search

Same measurement procedure as in clause K.1.1.

### K.2.2 RX beam peak direction search

Same measurement procedure as in clause K.1.2.

### K.2.3 Peak EIRP measurement procedure

Same measurement procedure as in clause K.1.3.

### K.2.4 Peak EIS measurement procedure

Same measurement procedure as in clause K.1.4.

### K.2.5 EIRP spherical coverage

Same measurement procedure as in clause K.1.5.

## K.2.6 EIS spherical coverage

Same measurement procedure as in clause K.1.6.

## K.2.7 TRP measurement procedure

Same measurement procedure as in clause K.1.7.

## K.2.8 Blocking measurement procedure

Same measurement procedure as in clause K.1.8.

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## K.3 Indirect far field (IFF)

### K.3.1 TX beam peak direction search

Same measurement procedure as in clause K.1.1.

### K.3.2 RX beam peak direction search

Same measurement procedure as in clause K.1.2.

### K.3.3 Peak EIRP measurement procedure

Same measurement procedure as in clause K.1.3.

### K.3.4 Peak EIS measurement procedure

Same measurement procedure as in clause K.1.4.

### K.3.5 EIRP spherical coverage

Same measurement procedure as in clause K.1.5.

### K.3.6 EIS spherical coverage

Same measurement procedure as in clause K.1.6.

### K.3.7 TRP measurement procedure

Same measurement procedure as in clause K.1.7.

### K.3.8 Blocking measurement procedure

Same measurement procedure as in clause K.1.8.

---

## K.4 Near field to far field transform (NFTF)

### K.4.1 TX beam peak direction search

The TX beam peak direction is found with a 3D EIRP scan (separately for each orthogonal polarization) with a grid that is TBD. The TX beam peak direction is where the maximum total component of EIRP is found.

FFS

### K.4.2 RX beam peak direction search

Not applicable for NFTF method.

### K.4.3 Peak EIRP measurement procedure

- 1) Connect the SS (System Simulator) to the DUT through the measurement antenna with polarization reference  $Pol_{Meas}$  to form the TX beam towards the previously determined TX beam peak direction and respective polarization.
- 2) Lock the beam toward that direction for the entire duration of the test.
- 3) Perform a 3D pattern measurement (amplitude and phase) with the DUT sending a modulated signal.
- 4) Determine the EIRP for both polarization towards the TX beam peak direction by using a Near Field to Far Field transform.
- 5) Calculate total EIRP =  $EIRP_{\theta} + EIRP_{\phi}$

### K.4.4 Peak EIS measurement procedure

Not applicable for NFTF method.

### K.4.5 EIRP spherical coverage

Same measurement procedure as in clause K.1.5.

### K.4.6 EIS spherical coverage

Not applicable for NFTF method.

### K.4.7 TRP measurement procedure

The minimum number of measurement points for TRP measurement grid is outlined in Annex M.4.

The measurement procedure includes the following steps:

- 1) Connect the SS to the DUT through the measurement antenna with polarization reference  $Pol_{Meas}$  to form the TX beam towards the previously determined TX beam peak direction and respective polarization.
- 2) Lock the beam toward that direction for the entire duration of the test.
- 3) Perform a 3D pattern measurement (amplitude and phase) with the DUT sending a modulated signal.
- 4) For each measurement point on the grid, determine the EIRP for both polarization by using a Near Field to Far Field transform.

5) The TRP value for the constant step size measurement grids are calculated using the TRP integration approaches outlined in Annex M.4.2. The TRP value for the constant density grid is calculated using the TRP integration formula in Annex M.4.3.

## K.4.8 Blocking measurement procedure

Not applicable for NFTF method.

## Annex L (normative): Void

## Annex M:(normative)

### Measurement grids

This appendix describes the assumptions and definition of the minimum number of measurement grid points for various grid types. Further details can be found in [5].

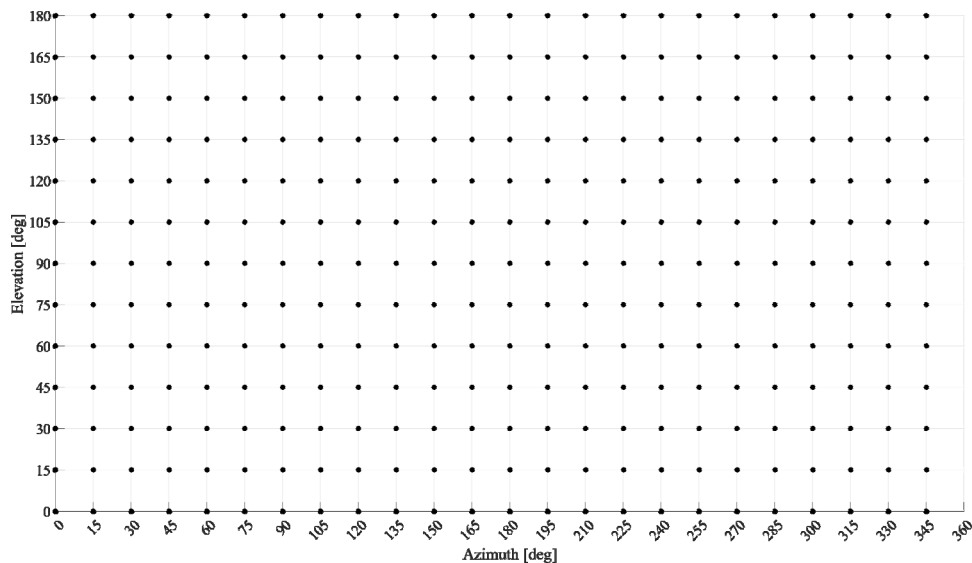
A total of three measurement grids are considered:

- Beam Peak Search Grid: using this grid, the TX and RX beam peak direction will be determined. 3D EIRP scans are used to determine the TX beam peak direction and 3D Throughput/RSRP/EIS scans for RX beam peak directions.
- Spherical Coverage Grid: using this grid, the CDF of the EIRP/EIS distribution in 3D is calculated to determine the spherical coverage performance.
- TRP Measurement Grid: using this grid, the total power radiated by the DUT in the TX beam peak direction is determined by integrating the EIRP measurements taken on the sampling grid.

## M.1 Grid Types

Two different measurement grid types are considered:

- The constant step size grid type has the azimuth and elevation angles uniformly distributed as in the examples illustrated in Figures M.1-1 in 2D and M.1-2 in 3D.



**Figure M.1-1: Distribution of measurement grid points in 2D for a constant step size grid with  $\Delta\theta=\Delta\phi=15^\circ$  (266 unique measurement points)**



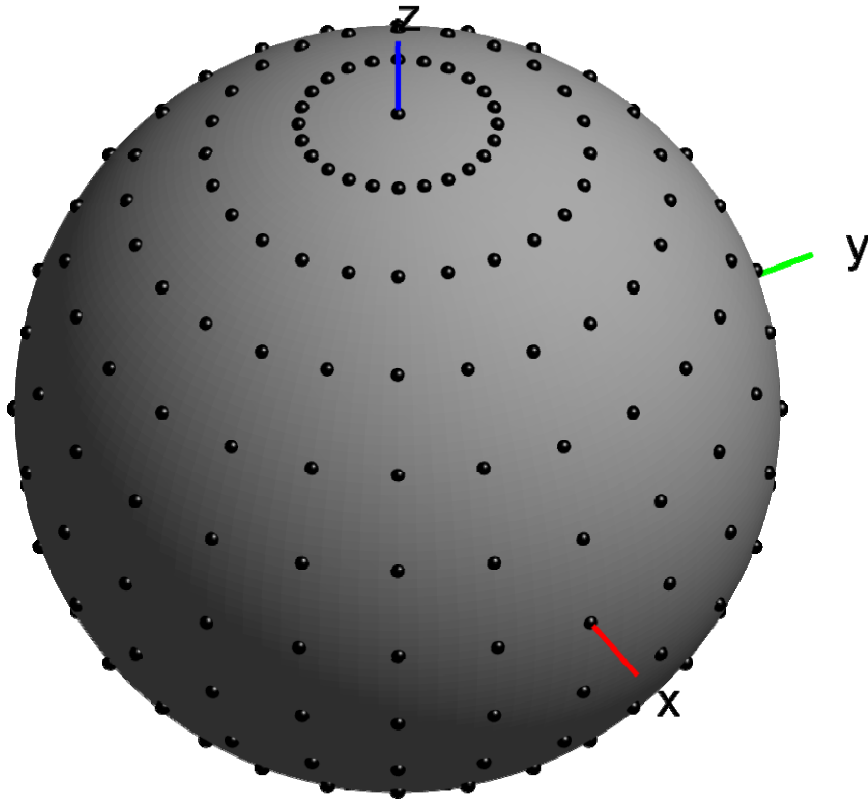


Figure M.1-2: Distribution of measurement grid points in 3D for a constant step size grid with  $\Delta\theta=\Delta\phi=15^\circ$  (266 unique measurement points)

- Constant density grid types have measurement points that are evenly distributed on the surface of the sphere with a constant density as in the example illustrated in Figures M.1-3 in 2D and M.1-4 in 3D.

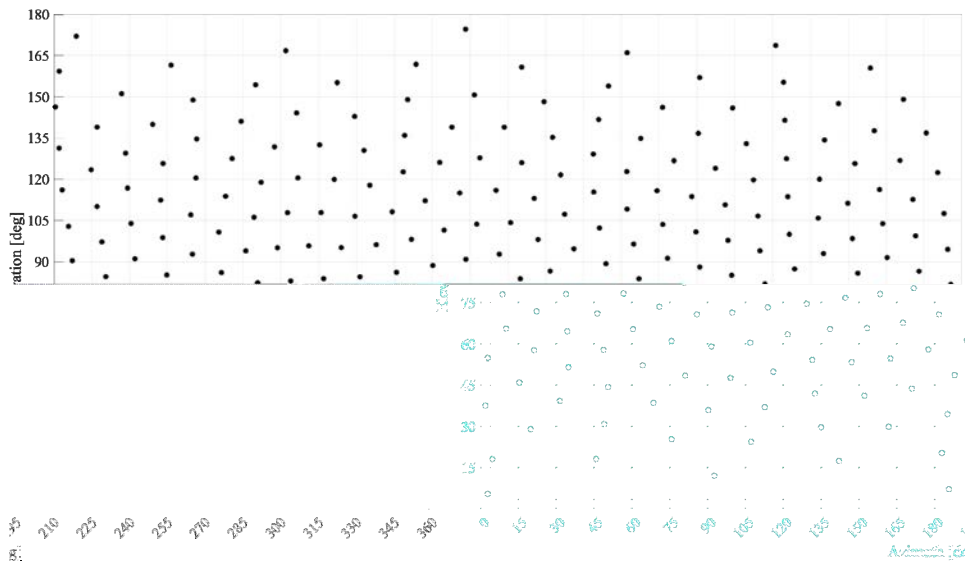


Figure M.1-3: Distribution of measurement grid points in 2D for a constant density grid with 266 unique measurement points

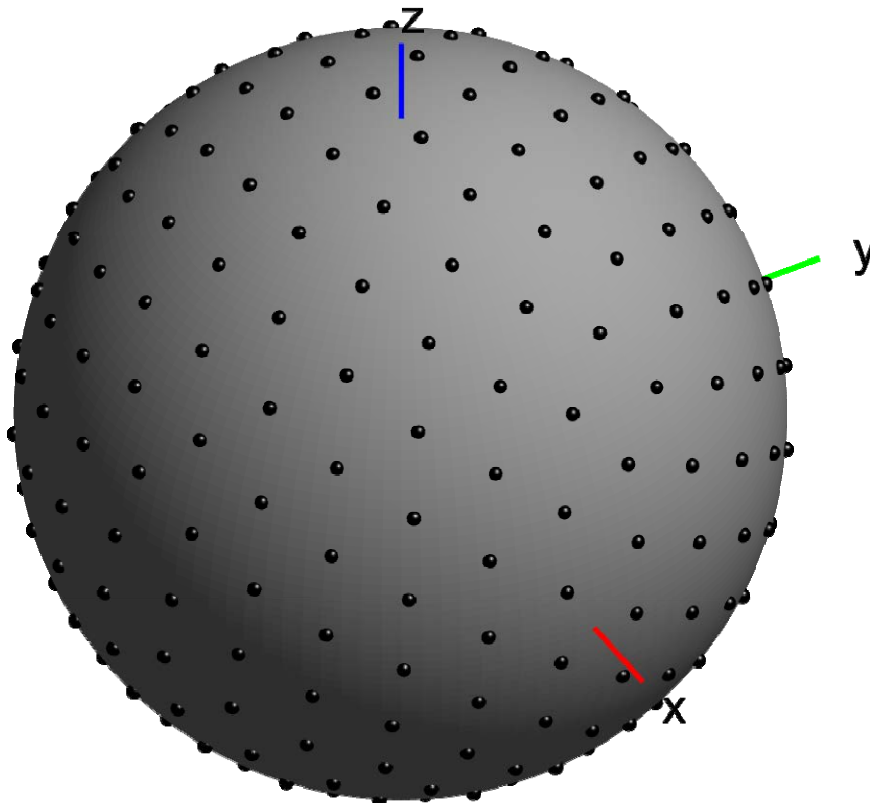


Figure M.1-4: Distribution of measurement grid points in 3D for a constant density grid type with 266 unique measurement points

## M.2 Beam Peak Search Grid

*Editor's note: Other implementations are not precluded as far as the respective analysis are presented and included in this TS*

### M.2.1 UE Power classes

#### M.2.1.1 Power class 1 devices

In order to make a reasonable trade-off with measurement uncertainties, it is recommended to use for beam peak search the following measurement grids leading to a systematic error of "Beam Peak Search" of 0.7 dB:

- Constant density grid (using the charged particle implementation) with at least 3000 grid points.
- Constant step size grid with at least 4902 grid points, corresponding to an angular step size of 3.6°.

For better measurement uncertainties, finer measurement grids as shown in Table M.2.1.1-1 may be used. Choice of grids among these 2 types of grids is up to test system implementation.

Table M.2.1.1-1: Minimum number of unique grid points for sample systematic errors

Systematic Error of 'Beam Peak Search': Offset from Beam Peak at which CDF is 5%	Minimum Number of Unique Grid Points for Constant Step Size Grid	Minimum Number of Unique Grid Points for Constant Density Grid
0.3dB	10226 (2.5° step size)	7000
0.4dB	N/A	5000
0.5dB	7082 (3°step size)	4500

0.6dB	N/A	3500
0.7dB	4902 (3.6° step size)	3000

### M.2.1.2 Power class 2 devices

TBD

### M.2.1.3 Power class 3 devices

In order to make a reasonable trade-off between measurement uncertainties, at least 800 (constant density grid with charged particle implementation) or 1106 (constant step size grid) measurement grid points shall be used for beam peak search procedures. For better measurement uncertainties, finer measurement grids as shown below may be used. Choice of grids among these 2 types of grids is up to test system implementation.

**Table M.2.1.3-1: Minimum number of unique grid points for sample systematic errors (non-sparse antenna arrays)**

Systematic Error of 'Beam Peak Search': Offset from Beam Peak at which CDF is 5%	Minimum Number of Unique Grid Points for Constant Step Size Grid	Minimum Number of Unique Grid Points for Constant Density Grid (charged particle implementation)
0.2dB	2522 (5° step size)	2000
0.3dB	1742 (6° step size)	1500
0.4dB	N/A	1000
0.5dB	1106 (7.5° step size)	800

Based on an optional vendor declaration with respect to the antenna array configuration, devices with an  $M \times N$  ( $M \geq N$ ) configuration with  $M \leq 4$  and  $N \leq 2$  can utilize either of the following minimum number of grid points with the same systematic error of 'Beam Peak Search' of 0.5dB for beam peak search procedures:

- 310 (constant density grid with charged particle implementation) measurement grid points.
- 422 (constant step size grid with  $\Delta\theta=\Delta\phi=12.0^\circ$ ) measurement grid points.

### M.2.1.4 Power class 4 devices

TBD

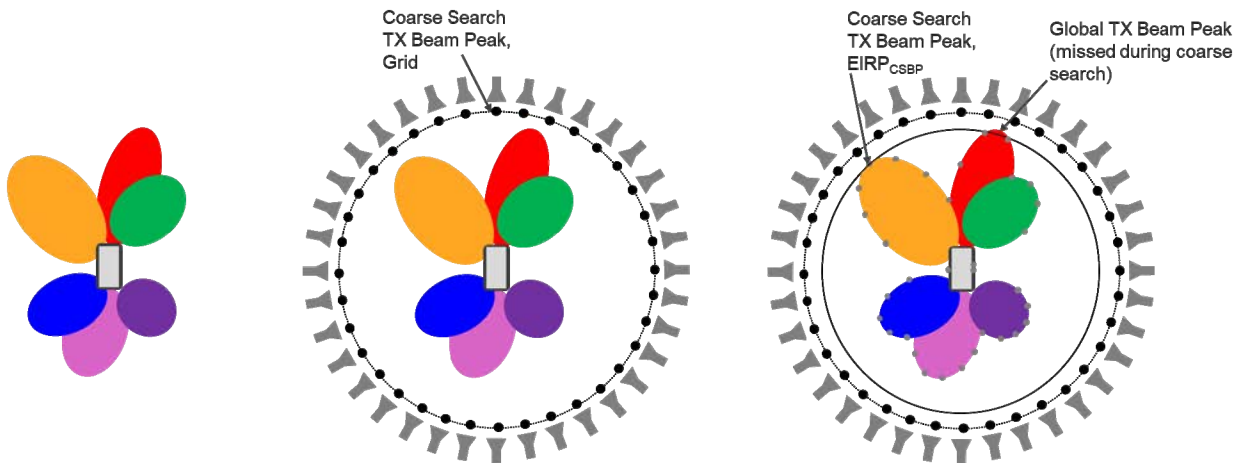
## M.2.2 Coarse and fine measurement grids

The baseline beam peak search is based on a single and fine beam peak search grid to determine the TX/RX beam peak of the DUT in any given direction. This means that even in sectors where poor EIRP/EIS performance is observed, a very fine grid is used to search for the TX/RX beam peak.

An optimized approach, based on an initial coarse search followed by a subsequent fine search could reduce the number of beam peak search grid points significantly. The basis for this approach is to use a coarse grid with fewer number of points than the ones described in section M.2.1 in the first stage to identify candidate regions that contain the global beam peak and search for the global beam peak with the fine grid in the second stage with a minimum number of points described in section M.2.1.

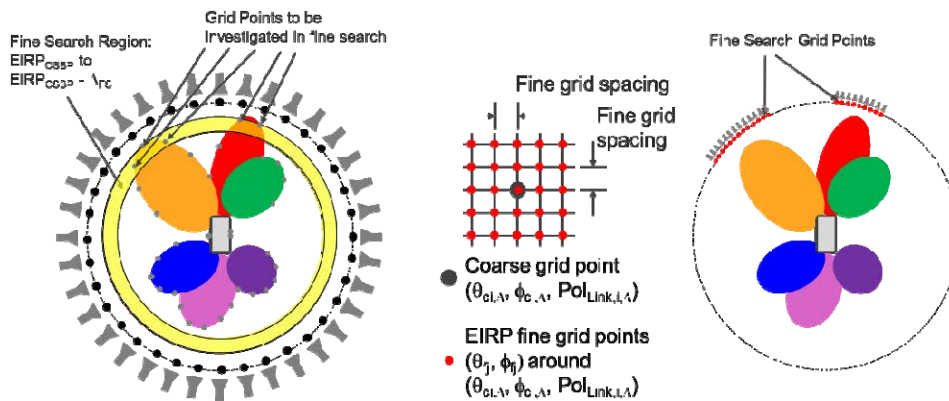
As an example, Figure M.2.2-1 illustrates the coarse and fine measurement grid approach applied to TX beam search; while this illustration is for EIRP, it can easily be extended to RX beam peak search using EIS or throughput metrics. For simplification purposes, 2D coarse and fine searches are illustrated but the concept can be extended to 3D easily. The UE is assumed to form a total of six beams in the 2D plane as illustrated on the left of Figure M.2.2-1. In the centre of Figure M.2.2-1, the 36 coarse beam peak search grid points in the 2D plane are illustrated. On the right, the grey circles on the respective antenna patterns illustrate the measured EIRP values towards each coarse grid point direction based on the respective beam steering directions. This illustration shows that the EIRP beam peak of the coarse search,

$EIRP_{CSBP}$ , is found to be the peak of the orange beam while the global TX beam peak (red beam) was not identified due to the coarse sampling of the grid points.



**Figure M.2.2-1: Illustration of the Coarse Search Approach for TX Beam Peak Search. Left: Antenna Pattern assumptions in 2D, Centre: Coarse beam peak search grid points/discrete antenna measurement positions, Right: TX beam EIRP measurements per grid point**

The proposed fine search approach is illustrated further in Figure M.2.2-2. A fine search region starting from the beam peak identified in the coarse search,  $EIRP_{CSBP}$ , over a range of  $\Delta_{FS}$  is used to identify the regions that need to be investigated more closely with the fine search algorithm. The fine search range  $\Delta_{FS}$  is a function of the angular spacing of the coarse beam peak search grid as well as the beam width of the reference antenna pattern considered for smartphone UEs.



**Figure M.2.2-2: Illustration of the fine beam peak search grid. Left: identify the measurement grid points that yielded EIRP values within the fine search region, right: placement of fine beam peak search grid points**

Figure M.2.2-3 illustrates coarse and fine grids for constant step size measurement grids while Figure M.2.2-4 illustrates the same for constant density grid.

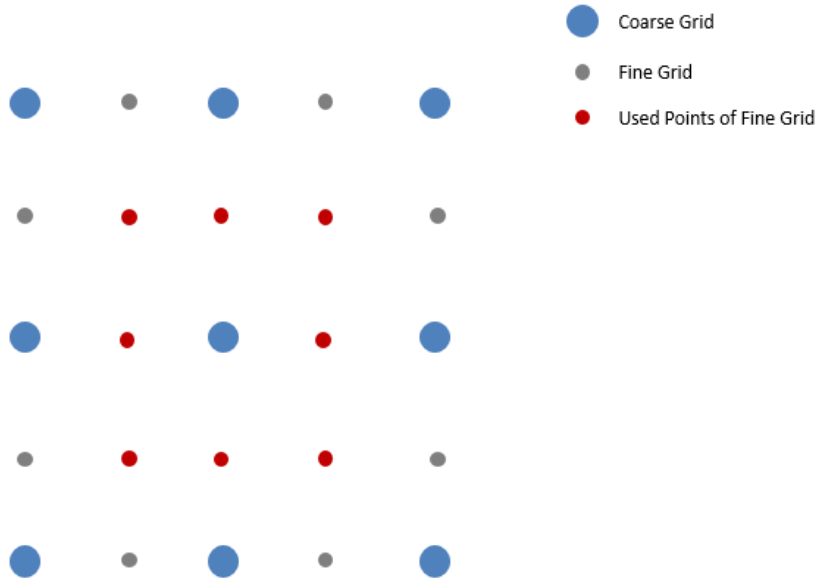


Figure M.2.2-3: Illustration: Coarse & Fine Constant Step Size Grids

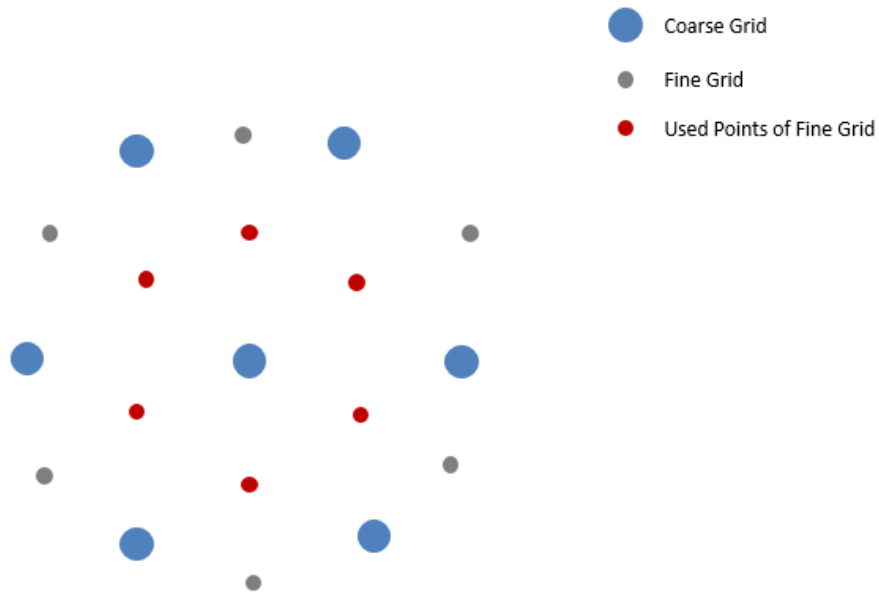


Figure M.2.2-4: Illustration: Coarse & Fine Constant Density Grids

The metric using a coarse & fine grid approach for the TX beam peak search is EIRP for both grids. For RX beam peak search either EIS or Throughput could be used for coarse grids while only EIS for fine grid,

### M.3 Spherical Coverage Grid

Editor’s note: Other implementations are not precluded as far as the respective analysis are presented and included in this TS

## M.3.1 EIRP spherical coverage

### M.3.1.1 UE Power classes

#### M.3.1.1.1 Power class 1 devices

In order to make a reasonable trade-off with measurement uncertainties, it is recommended to use the following recommendation in terms of min. number of grid points, standard deviation, and mean error for spherical coverage grids:

- constant density grid (using the charged particle implementation) with at least 200 grid points: standard deviation (MU element 'Influence of spherical coverage grid') of 0.13dB and 0.04dB Mean Error
- constant step size grid with at least 266 grid points: standard deviation (MU element 'Influence of spherical coverage grid') of 0.12dB and 0.06dB Mean Error

For better measurement uncertainties, finer measurement grids as shown in Tables M.3.1.1.1-1 and M.3.1.1.1-2 may be used. Choice of grids among these 2 types of grids is up to test system implementation.

There is no need to have the Tx beam peak placed on a measurement grid point.

For constant step size measurement grids, the CDF analyses require the PDFs to be scaled by  $\sin(\theta)$  or the normalized Clenshaw-Curtis weights  $W(\theta)/W(90^\circ)$ , introduced in Section M.4.2.1.

**Table M.3.1.1.1-1: Statistical results of EIRP<sub>85%CDF</sub> for the 12x12 antenna array for constant step size measurement grids and the beam peak oriented in completely random orientations.**

Step Size [°]	Number of unique grid points	Std. Dev [dB]	Mean Error  [dB]
12	422	0.10	0.03
15	266	0.12	0.06
20	146	0.23	0.05

**Table M.3.1.1.1-2: Statistical results of EIRP<sub>50%CDF</sub> for the 12x12 antenna array for constant density measurement grids and the beam peak oriented in completely random orientations.**

Number of unique grid points	Std. Dev [dB]	Mean Error  [dB]
150	0.15	0.06
175	0.13	0.04
200	0.13	0.04

#### M.3.1.1.2 Power class 2 devices

TBD

#### M.3.1.1.3 Power class 3 devices

In order to make a reasonable trade-off between measurement uncertainties, at least 200 (constant density grid with charged particle implementation) or 266 (constant step size grid) measurement grid points shall be used for EIRP spherical coverage procedure. For better measurement uncertainties, finer measurement grids as shown below may be used. Choice of grids among these 2 types of grids is up to test system implementation.

There is no need to have the Tx beam peak placed on a measurement grid point.

For constant step size measurement grids, the CDF analyses require the PDFs to be scaled by  $\sin(\theta)$  or the normalized Clenshaw-Curtis weights  $W(\theta)/W(90^\circ)$ , introduced in Section M.4.2.1.

**Table M.3.1.1.3-1: Statistical results of EIRP50%CDF for the 8x2 antenna array for constant density measurement grids (with charged particle implementation) and the beam peak oriented in completely random orientations errors (non-sparse antenna arrays)**

Number of unique grid points	STD [dB]	Mean Error  [dB]
200	0.11	0.02
300	0.08	0.01
400	0.07	0.01
500	0.06	0.01

**Table M.3.1.1.3-2: Statistical results of EIRP50%CDF for the 8x2 antenna array for constant step size measurement grids and the beam peak oriented in completely random orientations errors (non-sparse antenna arrays)**

Step Size [°]	Number of unique grid points	STD [dB]	Mean Error  [dB]
9	762	0.05	0.00
10	614	0.06	0.00
12	422	0.07	0.01
15	266	0.12	0.01

Based on an optional vendor declaration with respect to the antenna array configuration, devices with an  $M \times N$  ( $M \geq N$ ) configuration with  $M \leq 4$  and  $N \leq 2$  can utilize either of the following minimum number of grid points for spherical coverage procedures:

- 180 (constant density grid with charged particle implementation) measurement grid points with std. deviation of 0.12dB.
- 266 (constant step size grid with  $\Delta\theta=\Delta\phi=15.0^\circ$ ) measurement grid points with std. deviation of 0.11dB.

#### M.3.1.1.4 Power class 4 devices

TBD

### M.3.2 EIS spherical coverage

#### M.3.2.1 UE Power classes

##### M.3.2.1.1 Power class 1 devices

In order to make a reasonable trade-off with measurement uncertainties, it is recommended to use the following recommendation in terms of min. number of grid points, standard deviation, and mean error for spherical coverage grids:

- constant density grid (using the charged particle implementation) with at least 200 grid points: standard deviation (MU element 'Influence of spherical coverage grid') of 0.13dB and 0.04dB Mean Error
- constant step size grid with at least 266 grid points: standard deviation (MU element 'Influence of spherical coverage grid') of 0.12dB and 0.06dB Mean Error
- the MU element 'Systematic error related to EIS spherical coverage' is the DL step size, i.e., 0.2dB.

Choice of grids among these 2 types of grids is up to test system implementation.

There is no need to have the Rx beam peak placed on a measurement grid point.

For constant step size measurement grids, the CCDF analyses require the PDFs to be scaled by  $\sin(\theta)$  or the normalized Clenshaw-Curtis weights  $W(\theta)/W(90^\circ)$ , introduced in Section M.4.2.1.

### M.3.2.1.2 Power class 2 devices

TBD

### M.3.2.1.3 Power class 3 devices

In order to make a reasonable trade-off between measurement uncertainties, at least 200 (constant density grid with charged particle implementation) or 266 (constant step size grid) measurement grid points shall be used for EIS spherical coverage procedure. For better measurement uncertainties, finer measurement grids as shown below may be used. Choice of grid(s) among these 2 types of grids is up to test system implementation.

There is no need to have the Rx beam peak placed on a measurement grid point.

For constant step size measurement grids, the CCDF analyses require the PDFs to be scaled by  $\sin(\theta)$  or the normalized Clenshaw-Curtis weights  $W(\theta)/W(90^\circ)$ , introduced in Section M.4.2.1.

**Table M.3.2.1.3-1: Statistical results of EIS50%CDF for the 8x2 antenna array for constant step size measurement grids and the beam peak oriented in completely random orientations errors (non-sparse antenna arrays)**

Step Size [°]	Number of unique grid points	DL Power Step Size: infinitesimal		DL Power Step Size: 0.1dB		DL Power Step Size: 0.5dB		DL Power Step Size: 1dB	
		STD [dB]	Mean Error  [dB]	STD [dB]	Mean Error  [dB]	STD [dB]	Mean Error  [dB]	STD [dB]	Mean Error  [dB]
6.0	1742	0.03	0.00	0.03	0.10	0.03	0.50	0.02	1.02
9.0	762	0.05	0.00	0.05	0.10	0.05	0.50	0.04	1.02
10.0	614	0.06	0.00	0.06	0.10	0.06	0.50	0.05	1.02
12.0	422	0.08	0.01	0.07	0.10	0.07	0.50	0.07	1.02
15.0	266	0.12	0.02	0.12	0.10	0.11	0.50	0.10	1.02

**Table M.3.2.1.3-2: Statistical results of EIS50%CDF for the 8x2 antenna array for constant density measurement grids (with charged particle implementation) and the beam peak oriented in completely random orientations errors (non-sparse antenna arrays)**

Number of unique grid points	DL Power Step Size: infinitesimal		DL Power Step Size: 0.1dB		DL Power Step Size: 0.5dB		DL Power Step Size: 1dB	
	STD [dB]	Mean Error  [dB]	STD [dB]	Mean Error  [dB]	STD [dB]	Mean Error  [dB]	STD [dB]	Mean Error  [dB]
200	0.10	0.02	0.10	0.10	0.10	0.50	0.09	1.01
300	0.08	0.01	0.08	0.10	0.08	0.50	0.07	1.01
400	0.06	0.01	0.06	0.10	0.06	0.50	0.05	1.01
500	0.06	0.01	0.06	0.10	0.06	0.50	0.05	1.01



Based on an optional vendor declaration with respect to the antenna array configuration, devices with an  $M \times N$  ( $M \geq N$ ) configuration with  $M \leq 4$  and  $N \leq 2$  can utilize either of the following minimum number of grid points for spherical coverage procedures:

- 180 (constant density grid with charged particle implementation) measurement grid points with std. deviation of 0.12dB.
- 266 (constant step size grid with  $\Delta\theta=\Delta\phi=15.0^\circ$ ) measurement grid points with std. deviation of 0.11dB.

#### M.3.2.1.4 Power class 4 devices

TBD

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## M.4 TRP Measurement Grid

**Editor's note: Other implementations are not precluded as far as the respective analysis are presented and included in this TS**

### M.4.1 UE Power Classes

#### M.4.1.1 Power class 1 devices

In order to make a reasonable trade-off between measurement uncertainties, at least the following number of points shall be included in the measurement grid for TRP measurements PC1 UEs based on the assumption that the standard deviation does not exceed 0.25dB. If the re-positioning concept is not applied to TRP test cases:

- 500 measurement grid points for constant density grid – Charged Particle implementation, with standard deviation of 0.25 dB
- 25 latitudes and 48 longitudes (1106 unique grid points) for constant step size grid – sin (theta) weights integration approach, with standard deviation of 0.10dB with the allowance to skip and interpolate measurements at the pole at  $\theta=180^\circ$ , see Annex M.4.4
- 25 latitudes and 48 longitudes (1106 unique grid points) for constant step size grid – Clenshaw Curtis weights integration approach, with standard deviation of 0.07dB with the allowance to skip and interpolate measurements at the pole at  $\theta=180^\circ$ , see Annex M.4.4

If the re-positioning concept is applied to TRP test cases:

- 500 measurement grid points for constant density grid – Charged Particle implementation, with standard deviation of 0.25 dB with the allowance to skip and interpolate measurements for  $\theta \geq 150^\circ$ , see Annex M.4.4
- 25 latitudes and 48 longitudes (1106 unique grid points) for constant step size grid – sin (theta) weights integration approach, with standard deviation of 0.09dB with the allowance to skip and interpolate measurements for  $\theta \geq 157.5^\circ$ , see Annex M.4.4
- 25 latitudes and 48 longitudes (1106 unique grid points) for constant step size grid – Clenshaw-Curtis weights integration approach, with standard deviation of 0.03dB with the allowance to skip and interpolate measurements for  $\theta \geq 157.5^\circ$ , see Annex M.4.4
- 21 latitudes and 40 longitudes (762 unique grid points) for constant step size grid – Clenshaw Curtis weights integration approach, with standard deviation of 0.24 dB with the allowance to skip and interpolate measurements for  $\theta \geq 153^\circ$ , see Annex M.4.4

#### M.4.1.2 Power class 2 devices

TBD

### M.4.1.3 Power class 3 devices

In order to make a reasonable trade-off between measurement uncertainties, at least the following number of points should be included in the measurement grid for TRP measurements for non-sparse antenna arrays case. If the re-positioning concept is not applied to TRP test cases:

- 135 measurement grid points for constant density grid – Charged Particle implementation, with standard deviation of 0.23 dB
- 12 latitudes and 19 longitudes for constant step size grid – sin (theta) weights integration approach, with standard deviation of 0.25dB with the allowance to skip and interpolate measurements at the pole at  $\theta=180^\circ$ .
- 12 latitudes and 19 longitudes for constant step size grid – Clenshaw Curtis weights integration approach, with standard deviation of 0.20 dB with the allowance to skip and interpolate measurements at the pole at  $\theta=180^\circ$ .

If the re-positioning concept is applied to TRP test cases:

- 135 measurement grid points for constant density grid – Charged Particle implementation, with standard deviation of 0.23 dB with the allowance to skip and interpolate measurements for  $\theta \geq 165^\circ$ , see Annex M.4.4
- 150 measurement grid points for constant density grid – Charged Particle implementation, with standard deviation of 0.25 dB with the allowance to skip and interpolate measurements for  $\theta \geq 150^\circ$ , see Annex M.4.4
- 12 latitudes and 19 longitudes for constant step size grid – sin (theta) weights integration approach, with standard deviation of 0.25dB with the allowance to skip and interpolate measurements the at pole at  $\theta=180^\circ$ , see Annex M.4.4
- 12 latitudes and 19 longitudes for constant step size grid – Clenshaw Curtis weights integration approach, with standard deviation of 0.20 dB with the allowance to skip and interpolate measurements the at pole at  $\theta=180^\circ$ , see Annex M.4.4
- 13 latitudes and 24 longitudes for constant step size grid – sin (theta) weights integration approach, with standard deviation of 0.21dB with the allowance to skip and interpolate measurements for  $\theta \geq 165^\circ$ , see Annex M.4.4
- 13 latitudes and 24 longitudes for constant step size grid – Clenshaw Curtis weights integration approach, with standard deviation of 0.15 dB with the allowance to skip and interpolate measurements for  $\theta \geq 165^\circ$ , see Annex M.4.4.

Choice of grid(s) among above 3 types of grids is up to test system implementation.

Based on an optional vendor declaration with respect to the antenna array configuration, devices with an  $M \times N$  ( $M \geq N$ ) configuration with  $M \leq 4$  and  $N \leq 2$  can utilize either of the following minimum number of grid points for TRP procedures without the repositioning approach:

- 50 measurement grid points for constant density grid – Charged Particle implementation, with standard deviation of 0.14 dB.
- 80 measurement grid points for constant density grid – Charged Particle implementation, with standard deviation of 0.23 dB with the allowance to skip and interpolate measurements for  $\theta \geq 165^\circ$ , see Annex M.4.4.
- 8 latitudes and 14 longitudes (84 unique number of grid points) for constant step size grid – sin (theta) weights integration approach, with standard deviation of 0.25dB with the allowance to skip and interpolate measurements at the pole at  $\theta=180^\circ$ .
- 8 latitudes and 14 longitudes (84 unique number of grid points) for constant step size grid – Clenshaw Curtis weights integration approach, with standard deviation of 0.20 dB with the allowance to skip and interpolate measurements at the pole at  $\theta=180^\circ$ .

Either of the following minimum number of grid points for TRP procedures apply if the re-positioning is applied:

- 50 measurement grid points for constant density grid – Charged Particle implementation, with standard deviation of 0.14 dB with the allowance to skip and interpolate measurements for  $\theta \geq 150^\circ$ , see Annex M.4.4.
- 7 latitudes and 12 longitudes (62 unique number of grid points) for constant step size grid – Clenshaw Curtis weights integration approach, with standard deviation of 0.20 dB with the allowance to skip and interpolate measurements the at pole at  $\theta=180^\circ$ , see Annex M.4.4.

- 8 latitudes and 14 longitudes (86 unique number of grid points) for constant step size grid – sin(theta) weights integration approach, with standard deviation of 0.25dB with the allowance to skip and interpolate measurements for  $\theta \geq 154.29^\circ$ , see Annex M.4.4.
- 8 latitudes and 14 longitudes (86 unique number of grid points) for constant step size grid – Clenshaw Curtis weights integration approach, with standard deviation of 0.09 dB with the allowance to skip and interpolate measurements for  $\theta \geq 128.58^\circ$ , see Annex M.4.4.

Choice of grid(s) among above 3 types of grids is up to test system implementation.

#### M.4.1.4 Power class 4 devices

TBD

### M.4.2 TRP Integration for Constant Step Size Grid Type

Different approaches to perform the TRP integration from the respective EIRP measurements are outlined in the next sub clauses for the constant step size grid type.

#### M.4.2.1 TRP Integration using Weights

In many engineering disciplines, the integral of a function needs to be solved using numerical integration techniques, commonly referred to as “quadrature”. Here, the approximation of the integral of a function is usually stated as a weighted sum of function values at specified points within the domain of integration. The derivation from the closed surface TRP integral

$$TRP = \oiint_S \frac{EIRP(\theta, \phi)}{4\pi} \cdot \sin \theta \cdot d\theta d\phi$$

to the classical discretized summation equation used for OTA

$$TRP \approx \frac{\pi}{2NM} \sum_{i=1}^{N-1} \sum_{j=0}^{M-1} [EIRP_{\theta}(\theta_i, \phi_j) + EIRP_{\phi}(\theta_i, \phi_j)] \sin(\theta_i)$$

The weights for this integral are based on the  $\sin\theta \cdot \Delta\theta$  weights. More accurate implementations are based on the Clenshaw-Curtis quadrature integral approximation based on an expansion of the integrand in terms of Chebyshev polynomials. This implementation does not ignore the measurement points at the poles ( $\theta=0^\circ$  and  $180^\circ$ ) where  $\sin\theta = 0$ . The discretized TRP can be expressed as

$$TRP \approx \frac{1}{2M} \sum_{i=0}^N \sum_{j=0}^{M-1} [EIRP_{\theta}(\theta_i, \phi_j) + EIRP_{\phi}(\theta_i, \phi_j)] W(\theta_i)$$

which the  $\sin\theta \cdot \Delta\theta$  weights replaced by a weight function  $W(\theta)$  and extends the sum over I to include the poles. There is no simple closed-form expression for the Clenshaw-Curtis weights; however, a numerical straightforward approach is available, i.e.,

$$W(\theta_i) = \frac{c_i}{N} \left[ 1 - \sum_{j=1}^{\text{int}(\frac{N}{2})} \frac{b_j}{4j^2 - 1} \cos(2j\theta_i) \right]$$

with

$$b_j = \begin{cases} 1, & 2j = N \\ 2, & \text{otherwise} \end{cases}$$

and

$$c_i = \begin{cases} 1, & i = 0 \text{ or } N \\ 2, & \text{otherwise} \end{cases}$$

The Clenshaw-Curtis weights are compared to the classical  $\sin \theta \cdot \Delta\theta$  weights in Tables M.4.2.1-1 and M.4.2.1-2 for two different numbers of latitudes. The TRP measurement grid consists of  $N+1$  latitudes and  $M$  longitudes with

$$\theta_i = i\Delta\theta \text{ where } \Delta\theta = \frac{\pi}{N}$$

and

$$\phi_j = j\Delta\phi \text{ where } \Delta\phi = \frac{2\pi}{M}$$

**Table M.4.2.1-1: Samples and weights for the classical  $\sin \theta \cdot \Delta\theta$  weighting and Clenshaw-Curtis quadratures with 12 latitudes ( $\Delta\theta=16.4^\circ$ )**

Classical $\sin\theta \cdot \Delta\theta$		Clenshaw-Curtis	
$\theta$ [deg]	Weights	$\theta$ [deg]	Weights
0	0	0	0.008
16.4	0.08	16.4	0.079
32.7	0.154	32.7	0.155
49.1	0.216	49.1	0.216
65.5	0.26	65.5	0.26
81.8	0.283	81.8	0.283
98.2	0.283	98.2	0.283
114.6	0.26	114.6	0.26
130.9	0.216	130.9	0.216
147.3	0.154	147.3	0.155
163.6	0.08	163.6	0.079
180	0	180	0.008

**Table M.4.2.1-2: Samples and weights for the classical  $\sin \theta \cdot \Delta\theta$  weighting and Clenshaw-Curtis quadratures with 13 latitudes ( $\Delta\theta=15^\circ$ )**

Classical $\sin\theta \cdot \Delta\theta$		Clenshaw-Curtis	
$\theta$ [deg]	Weights	$\theta$ [deg]	Weights
0	0	0	0.007
15	0.0678	15	0.0661
30	0.1309	30	0.1315
45	0.1851	45	0.1848
60	0.2267	60	0.227
75	0.2529	75	0.2527
90	0.2618	90	0.262
105	0.2529	105	0.2527

120	0.2267	120	0.227
135	0.1851	135	0.1848
150	0.1309	150	0.1315
165	0.0678	165	0.0661
180	0	180	0.007

### M.4.3 TRP Integration for Constant Density Grid Types

For constant density grid types, the TRP integration should ideally take into account the area of the Voronoi region surrounding each grid point. Assuming an ideal constant density configuration of the grid points, the TRP can be approximated using

$$TRP \approx \frac{1}{N} \sum_{i=0}^{N-1} [EIRP_{\theta}(\theta_i, \phi_i) + EIRP_{\phi}(\theta_i, \phi_i)]$$

where N is the number of grid points of the constant density grid type.

### M.4.4 Interpolation at or near the Pole

As illustrated in Figure M.4.4-1, for systems that either do not allow measurements at the pole ( $\theta=180^\circ$ ), e.g., using distributed-axes positioners, or systems that have the positioners/support structures block the radiation towards the pole ( $\theta=180^\circ$ ), e.g., combined-axes positioners, measurements beyond  $150^\circ$  in  $\theta$  can be skipped and interpolated instead for measurement grids defined in Annex M.4.1.

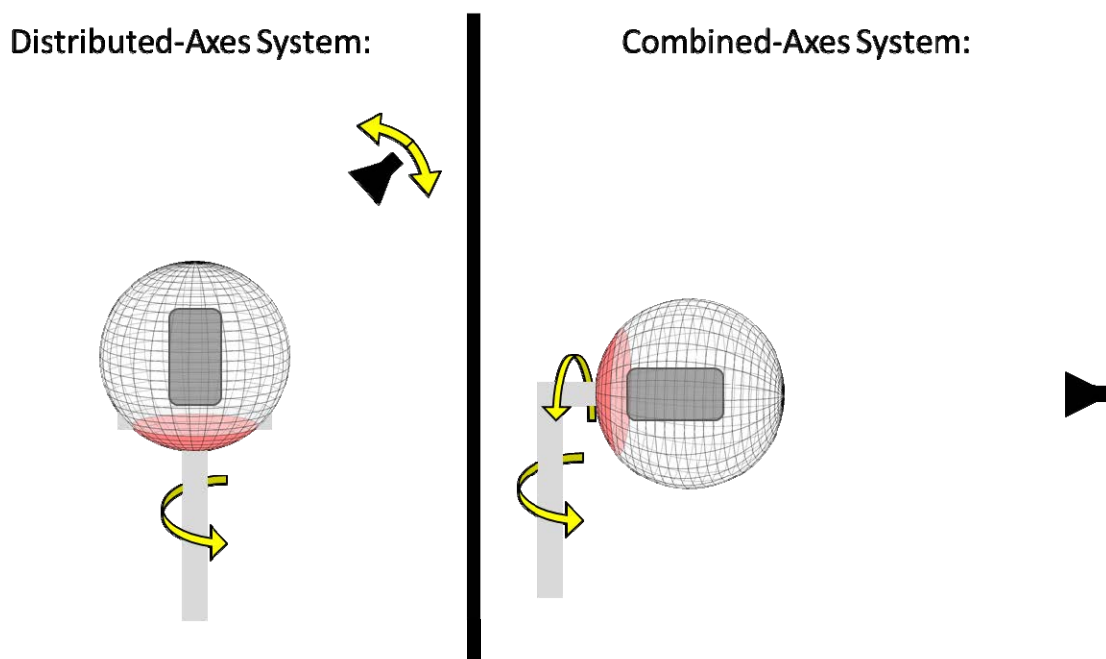


Figure M.4.4-1: Illustration of areas around the pole that either cannot be reached by the measurement antenna or are blocked by the positioner

### M.4.5 TRP Grids for Spurious Emissions

The worst antenna array assumptions for the MU simulations are outlined in Tables M.4.5-1 and M.4.5-2.

**Table M.4.5-1: Single Antenna Element Radiation Pattern for spurious emission measurements**

Antenna element horizontal radiation pattern	$A_{E,H}(\varphi) = -\min \left[ 12 \left( \frac{\varphi}{\varphi_{3dB}} \right)^2, A_m \right] \text{ dB}$ , $A_m = 30 \text{ dB}$
Horizontal half-power beam width of single element	260°
Antenna element vertical radiation pattern	$A_{E,V}(\theta) = -\min \left[ 12 \left( \frac{\theta - 90}{\theta_{3dB}} \right)^2, SLA_v \right]$ , $SLA_v = 30 \text{ dB}$
Vertical half-power beam width of single array element	130°
Array element radiation pattern	$A_E(\varphi, \theta) = G_{E,max} - \min \left\{ - \left[ A_{E,H}(\varphi) + A_{E,V}(\theta) \right], A_m \right\}$
Element gain without antenna losses	$G_{E,max} = 1.5 \text{ dBi}$

**Table M.4.5-2: Composite Antenna Array Radiation Pattern for spurious emission measurements**

Composite array radiation pattern in dB $A_A(\theta, \varphi)$	$A_{A,Beam_i}(\theta, \varphi) = A_E(\theta, \varphi) + 10 \log_{10} \left( \sum_{m=1}^{N_H} \sum_{n=1}^{N_V} w_{i,n,m} \cdot v_{n,m} \right)^2$ <p>the super position vector is given by:</p> $v_{n,m} = \exp \left( i \cdot 2\pi \left( (n-1) \cdot \frac{d_v}{\lambda} \cdot \cos(\theta) + (m-1) \cdot \frac{d_h}{\lambda} \cdot \sin(\theta) \cdot \sin(\varphi) \right) \right),$ <p><math>n = 1, 2, \dots, N_V; m = 1, 2, \dots, N_H;</math></p> <p>the weighting is given by:</p> $w_{i,n,m} = \frac{1}{\sqrt{N_H N_V}} \exp \left( i \cdot 2\pi \left( (n-1) \cdot \frac{d_v}{\lambda} \cdot \sin(\theta_{i,elit}) - (m-1) \cdot \frac{d_h}{\lambda} \cdot \cos(\theta_{i,elit}) \cdot \sin(\varphi_{i,escan}) \right) \right)$
Antenna array configuration (RowxColumn)	8 x 2
Horizontal radiating element spacing, $d_h/\lambda$	1
Vertical radiating element spacing, $d_v/\lambda$	1

The TRP measurement grid selection for spurious emissions is up to test system implementation but shall meet the criteria shown in Table M.4.5-3.

**Table M.4.5-3: TRP measurement grid requirement for spurious emission measurements**

Level of Grid	Grid Type	Standard Deviation of MU Element 'Influence of TRP Measurement'	Systematic error due to TRP calculation/quadrature	Number of unique grid points
Coarse	Constant Density	N/A	N/A	35
	Constant-Step Size	N/A	N/A	62 ( $\Delta\theta = \Delta\phi = 30^\circ$ )
Fine	Constant Density	0.32dB	0dB	135
	Constant-Step Size	0.31dB	0dB	266 ( $\Delta\theta = \Delta\phi = 15^\circ$ )

For spurious emissions, TRP measurements with measurement antennas displaced up to 10° from the focal point (based on electrical switching) in an IFF (based on CATR) test system, alternate TRP approaches for constant-step size grids are allowed for the coarse and fine grids:

interpolation to the non-offset system coordinate system that allows the use of Clenshaw-Curtis or classical  $\sin(\theta)$  quadratures

use of the advanced Jacobian matrix quadrature approach that uses triangulations of the sphere

## Annex N (normative): UE coordinate system

### N.1 Reference coordinate system

This annex defines the measurement coordinate system for the NR UE. The reference coordinate system as defined in IEEE Std 149 [27] is provided in Figure N.1-1 below while Figure N.1-2 shows an example DUT in the default alignment, i.e., the DUT and the reference coordinate systems are aligned with  $\alpha = 0^\circ$  and  $\beta = 0^\circ$  and  $\gamma = 0^\circ$  where  $\alpha$ ,  $\beta$ , and  $\gamma$  describe the relative angles between the two coordinate systems.

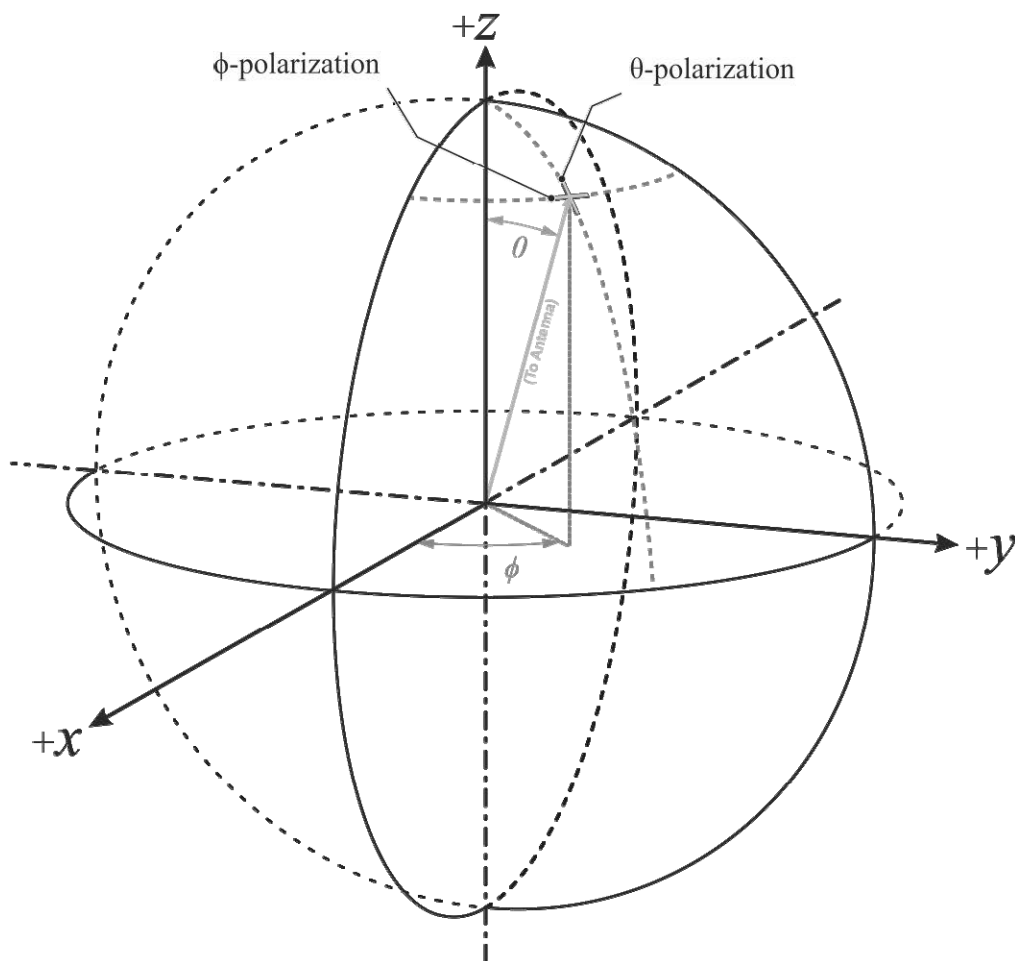
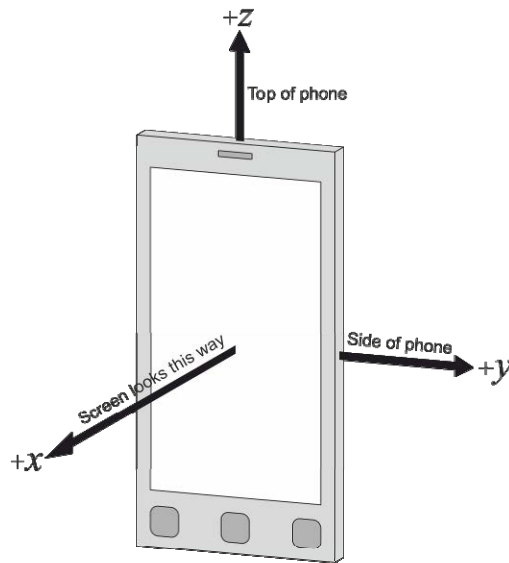


Figure N.1-1: Reference coordinate system





**Figure N.1-2: Example of DUT default alignment to coordinate system**

The following aspects are necessary:

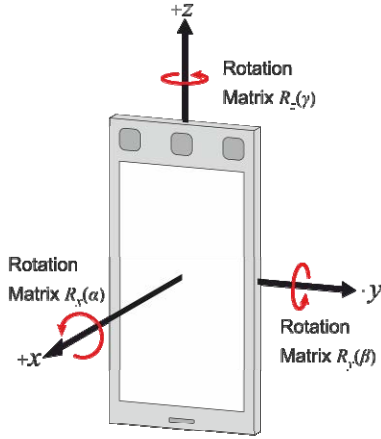
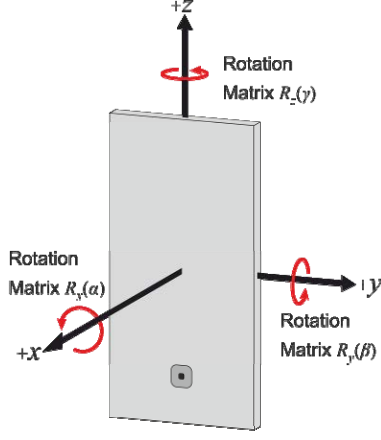
- A basic understanding of the top and bottom of the device is needed in order to define unambiguous DUT positioning requirements for the test, e.g., in the drawings used in this annex, the three buttons are on the bottom of the device (front) and the camera is on the top of the device (back).
- An understanding of the origin and alignment the coordinate system inside the test system i.e. the directions in which the x, y, z -axes points inside the test chamber is needed in order to define unambiguous DUT orientation, DUT beam, signal, interference, and measurement angles

## N.2 Test conditions and angle definitions

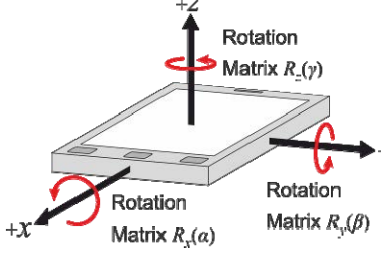
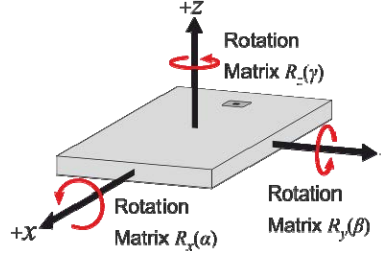
Tables N.2-1 through N.2-3 below provides the test conditions and angle definitions for three permitted device alignment for smartphones and tablets for the default test condition, DUT orientation 1, and two different options for each permitted device alignment to re-position the device for DUT Orientation 2 as outlined in Figures N.2-1 and N.2-3.

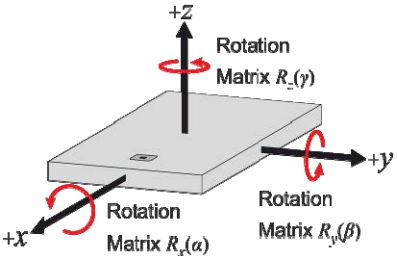
**Table N.2-1: Test conditions and angle definitions for smartphones and tablets for Alignment Option 1**

Test condition	DUT orientation	Link angle	Measurement angle	Diagram
Free space DUT Orientation 1 (default)	$\alpha = 0^\circ;$ $\beta = 0^\circ;$ $\gamma = 0^\circ$	$\theta_{Link};$ $\phi_{Link}$ with polarization reference $Pol_{Link} = \theta$ or $\phi$	$\theta_{Meas};$ $\phi_{Meas}$ with polarization reference $Pol_{Meas} = \theta$ or $\phi$	

<p>Free space DUT Orientation 2 – Option 1 (based on re-positioning approach)</p>	<p><math>\alpha = 180^\circ;</math> <math>\beta = 0^\circ;</math> <math>\gamma = 0^\circ</math></p>	<p><math>\theta_{Link};</math> <math>\phi_{Link}</math> with polarization reference <math>Pol_{Link} = \theta</math> or <math>\phi</math></p>	<p><math>\theta_{Meas};</math> <math>\phi_{Meas}</math> with polarization reference <math>Pol_{Meas} = \theta</math> or <math>\phi</math></p>	
<p>Free space DUT Orientation 2 – Option 2 (based on re-positioning approach)</p>	<p><math>\alpha = 0^\circ;</math> <math>\beta = 180^\circ;</math> <math>\gamma = 0^\circ</math></p>	<p><math>\theta_{Link};</math> <math>\phi_{Link}</math> with polarization reference <math>Pol_{Link} = \theta</math> or <math>\phi</math></p>	<p><math>\theta_{Meas};</math> <math>\phi_{Meas}</math> with polarization reference <math>Pol_{Meas} = \theta</math> or <math>\phi</math></p>	
<p>NOTE 1: A polarization reference, as defined in relation to the reference coordinate system in N.1-1, is maintained for each signal angle, link or interferer angle, and measurement angle. NOTE 2: The combination of rotations is captured by matrix <math>M=R_z(\gamma) \cdot R_y(\beta) \cdot R_x(\alpha)</math></p>				

**Table N.2-2: Test conditions and angle definitions for smartphones and tablets for Alignment Option 2**

Test condition	DUT orientation	Link angle	Measurement angle	Diagram
<p>Free space DUT Orientation 1 (default)</p>	<p><math>\alpha = 0^\circ;</math> <math>\beta = -90^\circ;</math> <math>\gamma = 0^\circ</math></p>	<p><math>\theta_{Link};</math> <math>\phi_{Link}</math> with polarization reference <math>Pol_{Link} = \theta</math> or <math>\phi</math></p>	<p><math>\theta_{Meas};</math> <math>\phi_{Meas}</math> with polarization reference <math>Pol_{Meas} = \theta</math> or <math>\phi</math></p>	
<p>Free space DUT Orientation 2 – Option 1 (based on re-positioning approach)</p>	<p><math>\alpha = 180^\circ;</math> <math>\beta = 90^\circ;</math> <math>\gamma = 0^\circ</math></p>	<p><math>\theta_{Link};</math> <math>\phi_{Link}</math> with polarization reference <math>Pol_{Link} = \theta</math> or <math>\phi</math></p>	<p><math>\theta_{Meas};</math> <math>\phi_{Meas}</math> with polarization reference <math>Pol_{Meas} = \theta</math> or <math>\phi</math></p>	

<p>Free space DUT Orientation 2 – Option 2 (based on re-positioning approach)</p>	<p><math>\alpha = 0^\circ</math>; <math>\beta = 90^\circ</math>; <math>\gamma = 0^\circ</math></p>	<p><math>\theta_{Link}</math>; <math>\phi_{Link}</math> with polarization reference <math>Pol_{Link} = \theta</math> or <math>\phi</math></p>	<p><math>\theta_{Meas}</math>; <math>\phi_{Meas}</math> with polarization reference <math>Pol_{Meas} = \theta</math> or <math>\phi</math></p>	
<p>NOTE 1: A polarization reference, as defined in relation to the reference coordinate system in N.1-1, is maintained for each signal angle, link or interferer angle, and measurement angle. NOTE 2: The combination of rotations is captured by matrix <math>M=R_z(\gamma) \cdot R_y(\beta) \cdot R_x(\alpha)</math></p>				

**Table N.2-3: Test conditions and angle definitions for smartphones and tablets for Alignment Option 3**

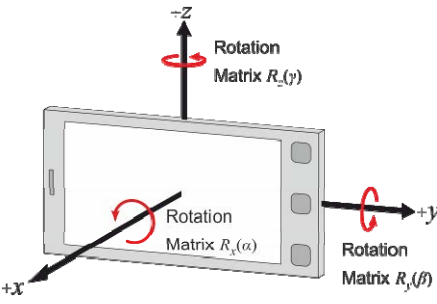
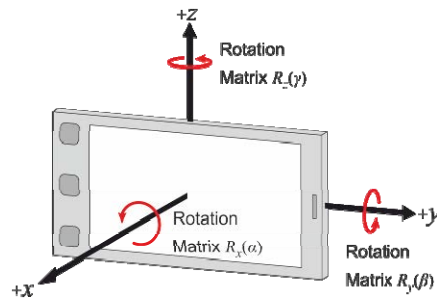
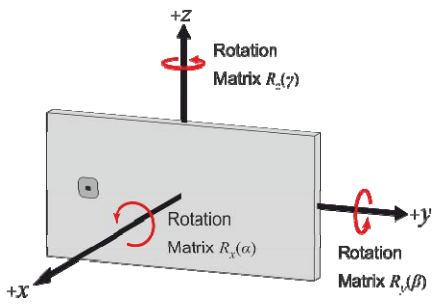
Test condition	DUT orientation	Link angle	Measurement angle	Diagram
<p>Free space DUT Orientation 1 (default)</p>	<p><math>\alpha = 90^\circ</math>; <math>\beta = 0^\circ</math>; <math>\gamma = 0^\circ</math></p>	<p><math>\theta_{Link}</math>; <math>\phi_{Link}</math> with polarization reference <math>Pol_{Link} = \theta</math> or <math>\phi</math></p>	<p><math>\theta_{Meas}</math>; <math>\phi_{Meas}</math> with polarization reference <math>Pol_{Meas} = \theta</math> or <math>\phi</math></p>	
<p>Free space DUT Orientation 2 – Option 1 (based on re-positioning approach)</p>	<p><math>\alpha = -90^\circ</math>; <math>\beta = 0^\circ</math>; <math>\gamma = 0^\circ</math></p>	<p><math>\theta_{Link}</math>; <math>\phi_{Link}</math> with polarization reference <math>Pol_{Link} = \theta</math> or <math>\phi</math></p>	<p><math>\theta_{Meas}</math>; <math>\phi_{Meas}</math> with polarization reference <math>Pol_{Meas} = \theta</math> or <math>\phi</math></p>	
<p>Free space DUT Orientation 2 – Option 2 (based on re-positioning approach)</p>	<p><math>\alpha = 90^\circ</math>; <math>\beta = 180^\circ</math>; <math>\gamma = 0^\circ</math></p>	<p><math>\theta_{Link}</math>; <math>\phi_{Link}</math> with polarization reference <math>Pol_{Link} = \theta</math> or <math>\phi</math></p>	<p><math>\theta_{Meas}</math>; <math>\phi_{Meas}</math> with polarization reference <math>Pol_{Meas} = \theta</math> or <math>\phi</math></p>	
<p>NOTE 1: A polarization reference, as defined in relation to the reference coordinate system in N.1-1, is maintained for each signal angle, link or interferer angle, and measurement angle. NOTE 2: The combination of rotations is captured by matrix <math>M=R_z(\gamma) \cdot R_y(\beta) \cdot R_x(\alpha)</math></p>				

Table N.2-4 below provides the test conditions and angle definitions for the permitted device alignment for laptops for the default test condition, DUT orientation 1, and two different options for each permitted device alignment to re-position the device for DUT Orientation 2 as outlined in Figures N.3-1 and N.3-2. The display is open at a lid angle of  $110^\circ \pm 5^\circ$ , where lid angle is defined as the angle between the front of the display to the levelled base, and the full projected volume is centred inside the test volume.

**Table N.2-4: Test conditions and angle definitions for laptops**

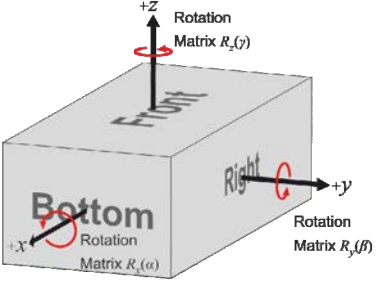
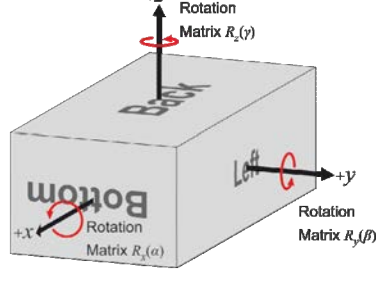
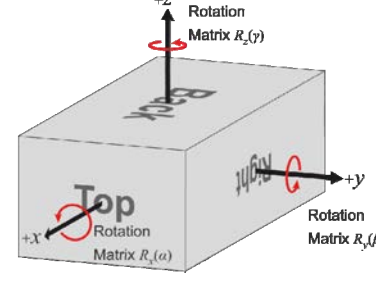
Test condition	DUT orientation	Link angle	Measurement angle	Diagram
Free space DUT Orientation (default)	$\alpha = 0^\circ$ ; $\beta = 0^\circ$ ; $\gamma = 0^\circ$	$\theta_{\text{Link}}$ ; $\phi_{\text{Link}}$ with polarization reference $\text{Pol}_{\text{Link}} = \theta$ or $\phi$	$\theta_{\text{Meas}}$ ; $\phi_{\text{Meas}}$ with polarization reference $\text{Pol}_{\text{Meas}} = \theta$ or $\phi$	
Free space DUT Orientation 2 – Option 1 (based on re-positioning approach)	$\alpha = 180^\circ$ ; $\beta = 0^\circ$ ; $\gamma = 0^\circ$	$\theta_{\text{Link}}$ ; $\phi_{\text{Link}}$ with polarization reference $\text{Pol}_{\text{Link}} = \theta$ or $\phi$	$\theta_{\text{Meas}}$ ; $\phi_{\text{Meas}}$ with polarization reference $\text{Pol}_{\text{Meas}} = \theta$ or $\phi$	
Free space DUT Orientation 2 – Option 2 (based on re-positioning approach)	$\alpha = 0^\circ$ ; $\beta = 180^\circ$ ; $\gamma = 0^\circ$	$\theta_{\text{Link}}$ ; $\phi_{\text{Link}}$ with polarization reference $\text{Pol}_{\text{Link}} = \theta$ or $\phi$	$\theta_{\text{Meas}}$ ; $\phi_{\text{Meas}}$ with polarization reference $\text{Pol}_{\text{Meas}} = \theta$ or $\phi$	

NOTE 1: A polarization reference, as defined in relation to the reference coordinate system in N.1-1, is maintained for each signal angle, link or interferer angle, and measurement angle.  
NOTE 2: The combination of rotations is captured by matrix  $M=R_z(\gamma) \cdot R_y(\beta) \cdot R_x(\alpha)$

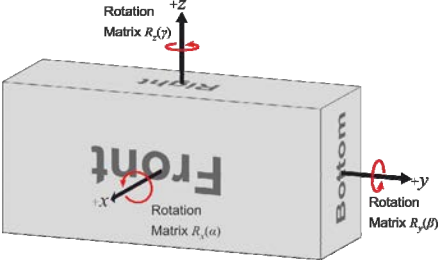
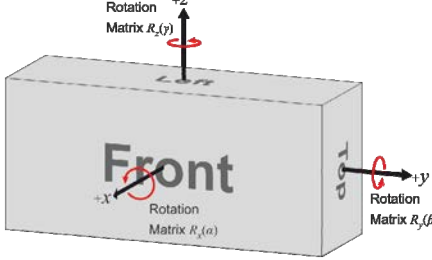
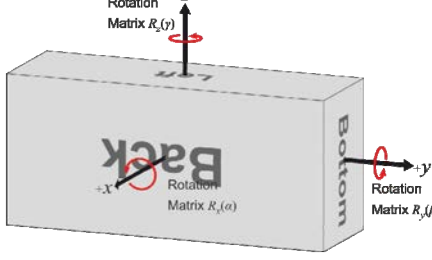
Tables N.2-5 through N.2-7 below provides the test conditions and angle definitions for the three permitted device alignment options for Fixed Wireless Access (FWA) for the default test condition, DUT orientation 1, and two different options for each permitted device alignment to re-position the device for DUT Orientation 2 as outlined in Figures N.3-1 and N.3-2. Due to changes in DUT orientations  $\alpha$ ,  $\beta$ , and  $\gamma$  for the alignment options for FWA proposed in Tables N.2-6 through N.2-7 when compared to those in Tables N.2-2 through N.2-3, new alignment options, i.e., Options 4 and 5, were introduced.

**Table N.2-5: Test conditions and angle definitions for FWA for Alignment Option 1**

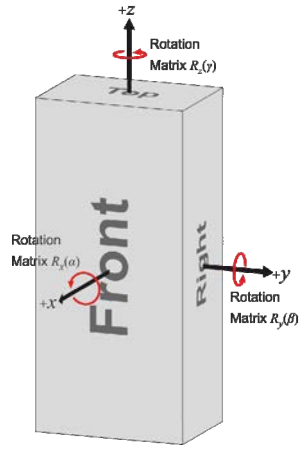
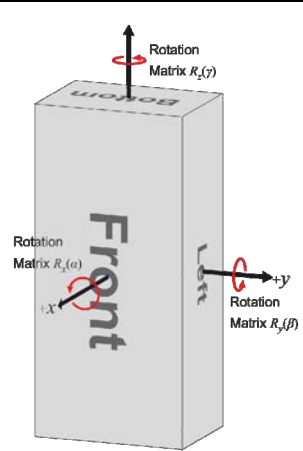
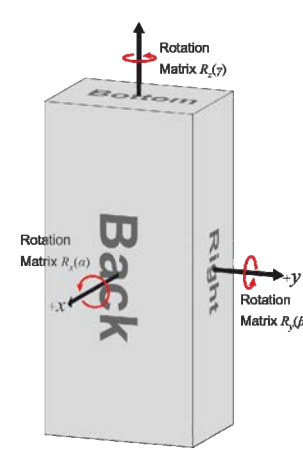
Test condition	DUT orientation	Link angle	Measurement angle	Diagram
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<p>Free space DUT Orientation 1 (default)</p>	<p><math>\alpha = 0^\circ</math>; <math>\beta = 0^\circ</math>; <math>\gamma = 0^\circ</math></p>	<p><math>\theta_{Link}</math>; <math>\phi_{Link}</math> with polarization reference <math>Pol_{Link} = \theta</math> or <math>\phi</math></p>	<p><math>\theta_{Meas}</math>; <math>\phi_{Meas}</math> with polarization reference <math>Pol_{Meas} = \theta</math> or <math>\phi</math></p>	
<p>Free space DUT Orientation 2 – Option 1 (based on re- positioning approach)</p>	<p><math>\alpha = 180^\circ</math>; <math>\beta = 0^\circ</math>; <math>\gamma = 0^\circ</math></p>	<p><math>\theta_{Link}</math>; <math>\phi_{Link}</math> with polarization reference <math>Pol_{Link} = \theta</math> or <math>\phi</math></p>	<p><math>\theta_{Meas}</math>; <math>\phi_{Meas}</math> with polarization reference <math>Pol_{Meas} = \theta</math> or <math>\phi</math></p>	
<p>Free space DUT Orientation 2 – Option 2 (based on re- positioning approach)</p>	<p><math>\alpha = 0^\circ</math>; <math>\beta = 180^\circ</math>; <math>\gamma = 0^\circ</math></p>	<p><math>\theta_{Link}</math>; <math>\phi_{Link}</math> with polarization reference <math>Pol_{Link} = \theta</math> or <math>\phi</math></p>	<p><math>\theta_{Meas}</math>; <math>\phi_{Meas}</math> with polarization reference <math>Pol_{Meas} = \theta</math> or <math>\phi</math></p>	
<p>NOTE 1: A polarization reference, as defined in relation to the reference coordinate system in N.1-1, is maintained for each signal angle, link or interferer angle, and measurement angle. NOTE 2: The combination of rotations is captured by matrix <math>M=R_z(\gamma) \cdot R_y(\beta) \cdot R_x(\alpha)</math></p>				

**Table N.2-6: Test conditions and angle definitions for FWA for Alignment Option 4**

Test condition	DUT orientation	Link angle	Measurement angle	Diagram
Free space DUT Orientation 1 (default)	$\alpha = 90^\circ;$ $\beta = 0^\circ;$ $\gamma = 90^\circ$	$\theta_{Link};$ $\phi_{Link}$ with polarization reference $Pol_{Link} = \theta$ or $\phi$	$\theta_{Meas};$ $\phi_{Meas}$ with polarization reference $Pol_{Meas} = \theta$ or $\phi$	
Free space DUT Orientation 2 – Option 1 (based on re-positioning approach)	$\alpha = -90^\circ;$ $\beta = 0^\circ;$ $\gamma = -90^\circ$	$\theta_{Link};$ $\phi_{Link}$ with polarization reference $Pol_{Link} = \theta$ or $\phi$	$\theta_{Meas};$ $\phi_{Meas}$ with polarization reference $Pol_{Meas} = \theta$ or $\phi$	
Free space DUT Orientation 2 – Option 2 (based on re-positioning approach)	$\alpha = -90^\circ;$ $\beta = 0^\circ;$ $\gamma = 90^\circ$	$\theta_{Link};$ $\phi_{Link}$ with polarization reference $Pol_{Link} = \theta$ or $\phi$	$\theta_{Meas};$ $\phi_{Meas}$ with polarization reference $Pol_{Meas} = \theta$ or $\phi$	
<p>NOTE 1: A polarization reference, as defined in relation to the reference coordinate system in N.1-1, is maintained for each signal angle, link or interferer angle, and measurement angle.</p> <p>NOTE 2: The combination of rotations is captured by matrix <math>M=R_z(\gamma) \cdot R_y(\beta) \cdot R_x(\alpha)</math></p>				

**Table N.2-7: Test conditions and angle definitions for FWA for Alignment Option 5**

Test condition	DUT orientation	Link angle	Measurement angle	Diagram
Free space DUT Orientation 1 (default)	$\alpha = 0^\circ;$ $\beta = 90^\circ;$ $\gamma = 0^\circ$	$\theta_{\text{Link}};$ $\phi_{\text{Link}}$ with polarization reference $\text{Pol}_{\text{Link}} = \theta$ or $\phi$	$\theta_{\text{Meas}};$ $\phi_{\text{Meas}}$ with polarization reference $\text{Pol}_{\text{Meas}} = \theta$ or $\phi$	
Free space DUT Orientation 2 – Option 1 (based on re-positioning approach)	$\alpha = 180^\circ;$ $\beta = -90^\circ;$ $\gamma = 0^\circ$	$\theta_{\text{Link}};$ $\phi_{\text{Link}}$ with polarization reference $\text{Pol}_{\text{Link}} = \theta$ or $\phi$	$\theta_{\text{Meas}};$ $\phi_{\text{Meas}}$ with polarization reference $\text{Pol}_{\text{Meas}} = \theta$ or $\phi$	
Free space DUT Orientation 2 – Option 2 (based on re-positioning approach)	$\alpha = 0^\circ;$ $\beta = -90^\circ;$ $\gamma = 0^\circ$	$\theta_{\text{Link}};$ $\phi_{\text{Link}}$ with polarization reference $\text{Pol}_{\text{Link}} = \theta$ or $\phi$	$\theta_{\text{Meas}};$ $\phi_{\text{Meas}}$ with polarization reference $\text{Pol}_{\text{Meas}} = \theta$ or $\phi$	
<p>NOTE 1: A polarization reference, as defined in relation to the reference coordinate system in N.1-1, is maintained for each signal angle, link or interferer angle, and measurement angle.</p> <p>NOTE 2: The combination of rotations is captured by matrix <math>M=R_z(\gamma) \cdot R_y(\beta) \cdot R_x(\alpha)</math></p>				

For each UE requirement and test case, each of the parameters in Table N.2-1 through N.2-7 need to be recorded, such that DUT positioning, DUT beam direction, and angles of the signal, link/interferer, and measurement are specified in terms of the fixed coordinate system.

Due to the non-commutative nature of rotations, the order of rotations is important and needs to be defined when multiple DUT orientations are tested.

The rotations around the x, y, and z axes can be defined with the following rotation matrices

$$R_x(\alpha) = \begin{bmatrix} 1 & 0 & 0 & 0 \\ 0 & \cos \alpha & -\sin \alpha & 0 \\ 0 & \sin \alpha & \cos \alpha & 0 \\ 0 & 0 & 0 & 1 \end{bmatrix}$$

$$R_y(\beta) = \begin{bmatrix} \cos \beta & 0 & \sin \beta & 0 \\ 0 & 1 & 0 & 0 \\ -\sin \beta & 0 & \cos \beta & 0 \\ 0 & 0 & 0 & 1 \end{bmatrix}$$

and

$$R_z(\gamma) = \begin{bmatrix} \cos \gamma & -\sin \gamma & 0 & 0 \\ \sin \gamma & \cos \gamma & 0 & 0 \\ 0 & 0 & 1 & 0 \\ 0 & 0 & 0 & 1 \end{bmatrix}.$$

with the respective angles of rotation,  $\alpha$ ,  $\beta$ ,  $\gamma$ , and

$$\begin{bmatrix} x' \\ y' \\ z' \\ 1 \end{bmatrix} = R \begin{bmatrix} x \\ y \\ z \\ 1 \end{bmatrix}$$

Additionally, any translation of the DUT can be defined with the translation matrix

$$T(t_x, t_y, t_z) = \begin{bmatrix} 1 & 0 & 0 & t_x \\ 0 & 1 & 0 & t_y \\ 0 & 0 & 1 & t_z \\ 0 & 0 & 0 & 1 \end{bmatrix}$$

with offsets  $t_x$ ,  $t_y$ ,  $t_z$  in x, y, and z, respectively and with

$$\begin{bmatrix} x' \\ y' \\ z' \\ 1 \end{bmatrix} = T \begin{bmatrix} x \\ y \\ z \\ 1 \end{bmatrix}$$

The combination of rotations and translation is captured by the multiplication of rotation and translation matrices.

For instance, the matrix M

$$M = T(t_x, t_y, t_z) \cdot R_z(\gamma) \cdot R_y(\beta) \cdot R_x(\alpha)$$

describes an initial rotation of the DUT around the x axis with angle  $\alpha$ , a subsequent rotation around the y axis with angle  $\beta$ , and a final rotation around the z axis with angle  $\gamma$ . After those rotations, the DUT is translated by  $t_x$ ,  $t_y$ ,  $t_z$  in x, y, and z, respectively.



## N.3 DUT positioning guidelines

Near-field coupling effects between the antenna and the pedestals/positioners/fixtures generally cause increased signal ripples. Re-positioning the DUT by directing the beam peak away from those areas can reduce the effect of signal ripple on EIRP/EIS measurements. Figure N.3-1 and N.3-2 illustrate how to reposition the DUT in distributed axes and combined axes system, when the beam peak is directed to the DUTs upper hemisphere (DUT orientation 1) or the DUTs lower hemisphere (DUT orientation 2). While these figures are examples of different positioning systems and other implementations are not precluded, the relative orientation of the coordinate system with respect to the antennas/reflectors and the axes of rotation shall apply to any measurement setup.

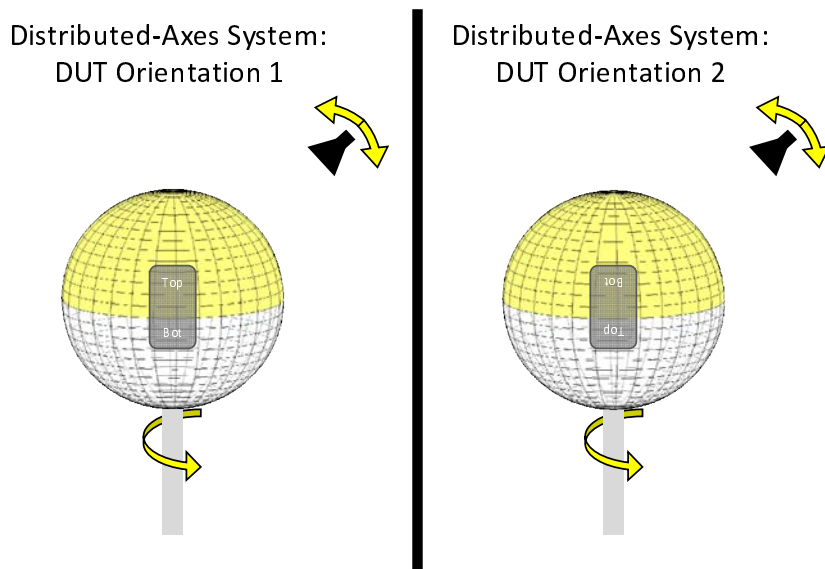


Figure N.3-1: DUT re-positioning for an example of distributed-axes system

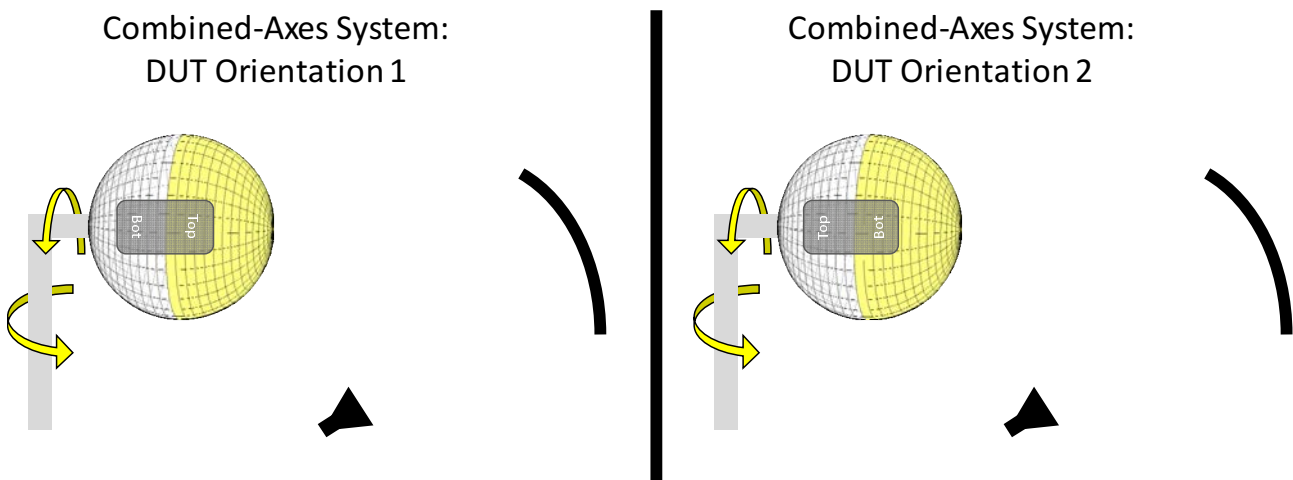
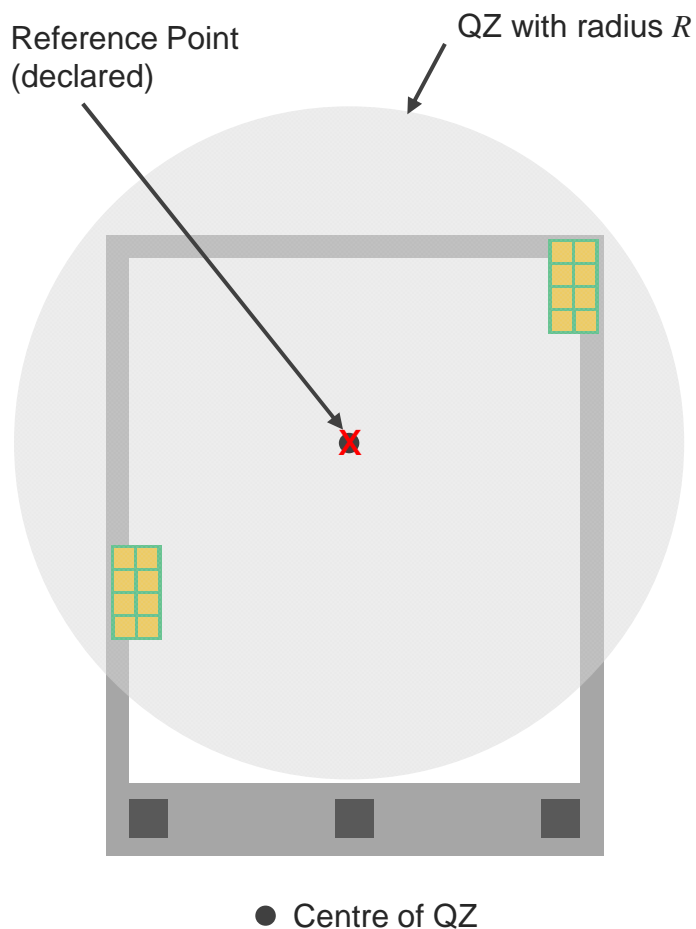


Figure N.3-2: DUT re-positioning for an example of combined-axes system

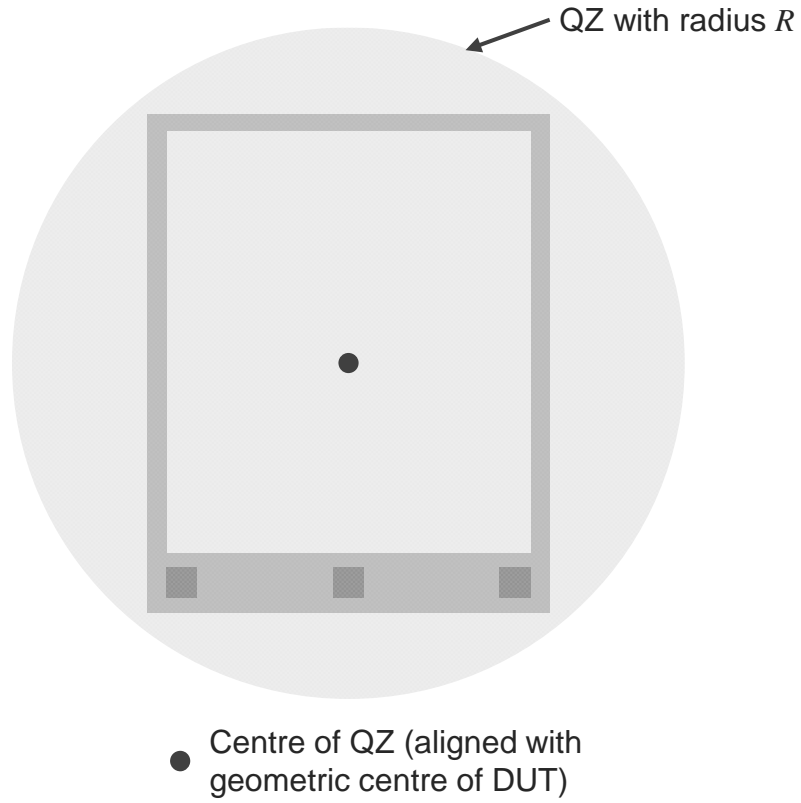
For EIRP/EIS measurements, re-positioning the DUT makes sure the pedestal is not obstructing the beam path and that the pedestal is not in closer proximity to the measurement antenna/reflector than the DUT. For TRP measurements, re-positioning the DUT makes sure that the beam peak direction is not obstructed by the pedestal and the pedestal is in the measurement path only when measuring the back-hemisphere. No re-positioning during the TRP measurement is required.

The radiating portions of the device have to be fully enclosed within the quiet zone, but the non-radiating portions of the device can be located/placed outside the quiet zone if a vendor declaration with positioning reference points and the minimum QZ required to contain all active antennas within the quiet zone (per band) is provided. This grey-box testing approach where the declared reference point is aligned with the centre of the QZ is further illustrated in Figure N.3-3.



**Figure N.3-3: Grey-box test approach**

In the absence of a vendor declaration, the geometric centre of the DUT shall be aligned with the centre of the QZ and the DUT shall be fully contained within the QZ. This black-box testing approach is further illustrated in Figure N.3-4.



**Figure N.3-4: Black-box test approach**

## Annex O: Quality of the quiet zone validation

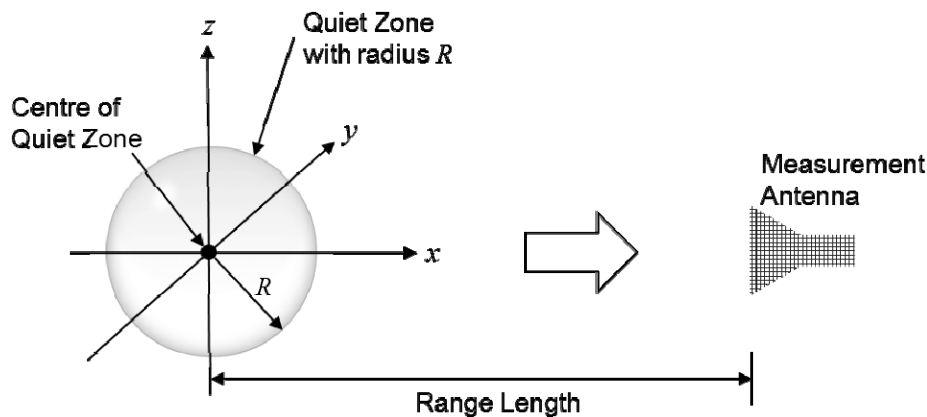
### O.1 General

This annex describes the procedures for validating the quality of the quiet zone for the permitted far-field methods outlined in Annex B.2.2 (DFF), B.2.3 (simplified DFF), and in B.2.4 (IFF based on CATR) in [10]. Annex O.2 focuses on the procedure for in-band and OOB test cases while Annex O.3 focuses on the procedure for spurious emissions test cases. These procedures are applicable to PC1 and PC3 UEs.

### O.2 Procedure to characterize the quality of the quiet zone for in-band/OOB for the permitted far field methods

This procedure is mandatory before the test system is commissioned for certification tests and characterizes the quiet zone performance of the anechoic chamber, specifically the effect of reflections within the anechoic chamber including any positioners and support structures. Additionally, it includes the effect of offsetting the directive antenna array inside a DUT from the centre of the quiet zone, i.e., the centre of rotation of the DUT and measurement antenna positioning systems as well as the directivity MU, i.e., the variation of antenna gains in the different direct line-of-sight links.

The quiet zone is illustrated in Figure O.2-1 which includes the definitions of centre of quiet zone range, i.e., the geometric centre of the positioning systems, and the range length, i.e., the distance between the centre of the quiet zone and the aperture of the measurement antenna.



**Figure O.2-1: Quiet Zone Illustration**

The outcome of the procedures can be used to predict the

- variation of the TRP measurements, spherical surface integrals of EIRP/EIS, when the DUT is placed anywhere within the quiet zone and with the beam formed in any arbitrary direction inside the chamber
- variation of the EIRP/EIS measurements when the DUT is placed anywhere within the quiet zone and with the beam formed in any arbitrary direction inside the chamber

The reference coordinate system defined in Annex N applies to this procedure.

#### O.2.1 Equipment used

The reference antenna under test (AUT) that is placed at various locations within the quiet zone shall be a directive antenna with similar properties of typical antenna arrays integrated in DUTs. The characteristics in terms of Directivity and Half Power Beamwidth (HPBW) of the reference AUT are shown in Figure O.2.1-1, O.2.1-2, and O.2.1-3.

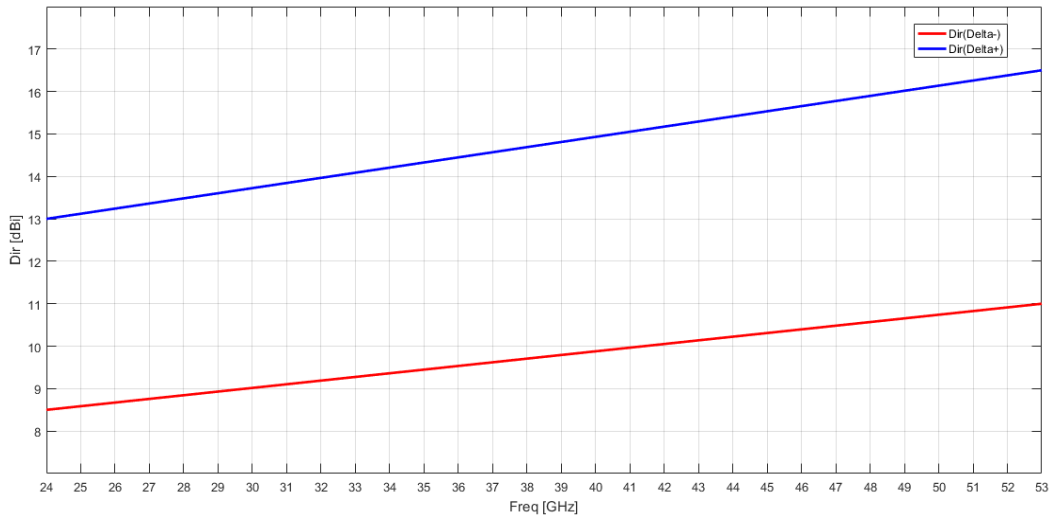


Figure O.2.1-1: Directivity mask

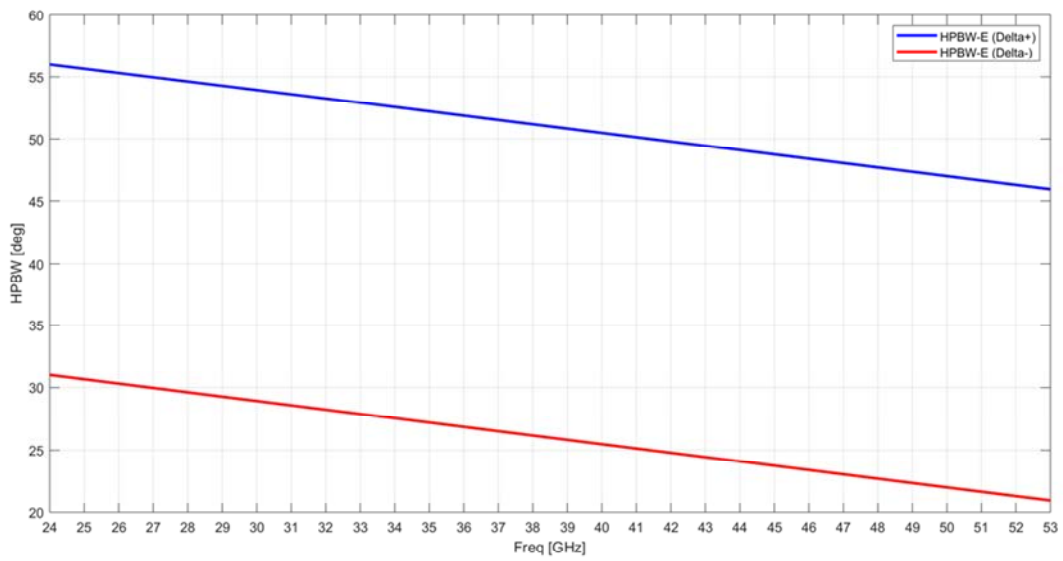


Figure O.2.1-2: 2xHPBW-E mask

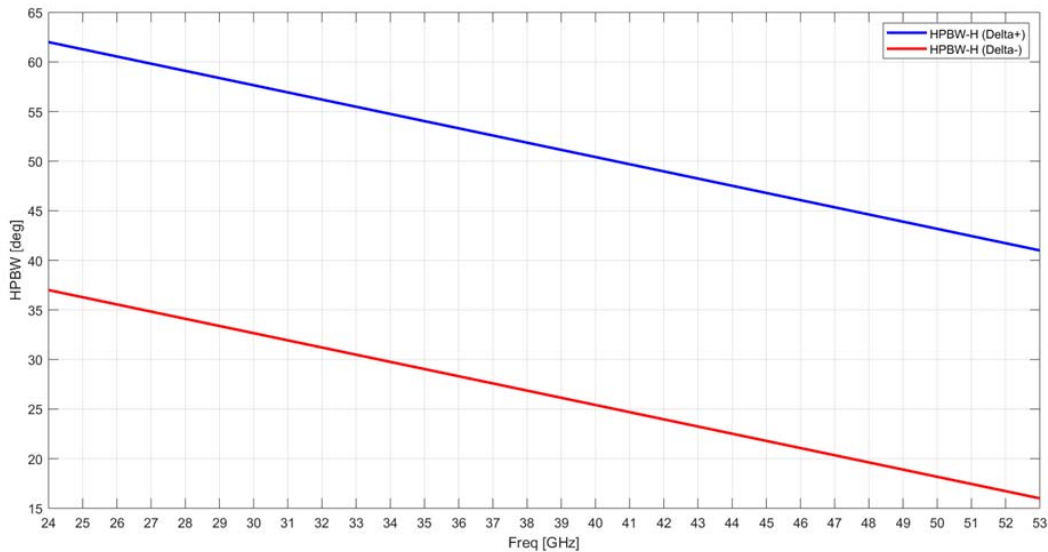


Figure O.2.1-3: 2xHPBW-H mask

AUT shall be symmetric on E and H planes.

The above masks for the reference antenna are met based on antenna vendors' calibration report.

For the measurement, a combination of signal generator and spectrum analyser or a network analyser can be used. The multi-port (with three ports) network analyser is most suitable to reduce test time as both polarizations of the measurement antenna can be measured simultaneously, and multiple frequencies can be measured in a sweep.

## O.2.2 Test frequencies

The frequencies to be used to characterize the quality of the quiet zone are 23.45 GHz, 32.125 GHz, 40.8 GHz, 44.3 GHz, and 49 GHz. The quiet zone validation analysis is performed for each frequency individually.

## O.2.3 Reference measurements

The quality of the quiet measurements for integrated RF parameters such as TRP shall use 3D pattern measurements of the reference antenna patterns as they most closely resemble the 3D/spherical surface measurements/integrals of EIRP or EIS. Therefore, the quality of the quiet zone measurements for TRP metrics shall be based on efficiency measurements. On the other hand, the quality of the quiet zone measurements for single-directional EIRP and EIS metrics shall be based on gain measurements of the direct line-of-sight link between the reference AUT and the measurement antenna.

The grid types for the TRP measurements shall match those outlined in M.1 and the minimum number of grid points (including quadratures for constant step size grids and implementation of constant density grids) shall meet the 0.25 dB maximum standard uncertainty summarized in M.4.

## O.2.4 Size of the quiet zone

The size of the quiet zone within which the variations of measurements are evaluated depends on the size of the DUT. For smartphones, the quiet zone shall be considered a sphere with radius of  $R=10\text{cm}$ . For larger smartphones and tablet type devices, the quiet zone shall be considered a sphere with radius of  $R=15\text{cm}$ . For even larger device, e.g., larger tablets and laptops, quiet zones of radius  $R=20\text{cm}$  and  $R=27.5\text{cm}$  shall be considered. Alternate quiet zone sizes can be defined for even larger DUTs.

The quality of quiet zone procedure for systems supporting multiple quiet zone sizes can be performed for the largest quiet zone radius only and the results can be applied to the smaller quiet zone radii if the same chamber components

affecting QoQZ, i.e., reflector, feed probes, etc, are used. Performing separate sets of quality of quiet zone measurements for different radii is not precluded.

## O.2.5 Reference AUT positions

The reference AUT shall be positioned in a total of 7 different reference positions, shown in Figure O.2.5.1-1 and O.2.5.2-1

While position 1, P1, is the centre of the quiet zone, the remaining positions, 2 through 7, are off-centre positions each displaced by the radius of the quiet zone,  $R$ . The coordinates of the respective test points are shown in Table O.2.5-1.

**Table O.2.5-1: Reference AUT Measurement Coordinates**

Position	$x$	$y$	$z$
P1	0	0	0
P2	$R$	0	0
P3	$-R$	0	0
P4	0	$R$	0
P5	0	$-R$	0
P6	0	0	$R$
P7	0	0	$-R$

For quiet zones exceeding 30cm in diameter, i.e.,  $R=20$ cm and  $R=27.5$ cm, an alternate set of reference points can be selected for the quality of quiet zone evaluation, summarized in Table O.2.5-2

**Table O.2.5-2: Alternate Reference AUT Measurement Coordinates for  $R=20$ cm and  $R=27.5$ cm Quiet Zones**

Position	$x$	$y$	$z$
P1	0	0	0
P2	$R$	0	0
P3	$-R$	0	0
P4	0	$R$	0
P5	0	$-R$	0
P6	0	0	$z_6$
P7	0	0	$-z_7$

Note:  $z_6$  and  $z_7$  are the maximum declared DUT heights in  $\pm z$  defined in the chamber specification and are bound to a minimum of 15cm. The DUT antennas (grey-box approach)/the DUT (black box approach) cannot extend past these heights within the QZ (in  $z$ ) when installed in the system.

### O.2.5.1 Distributed-axes system

The reference AUT shall be positioned in a total of 7 different reference positions, shown in Figure O.2.5.1-1.

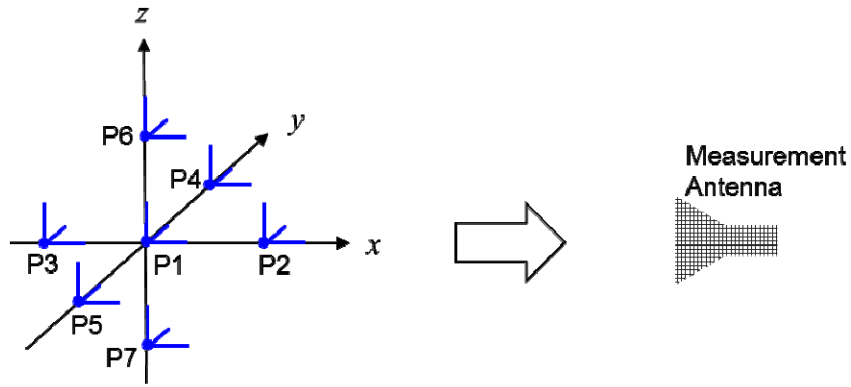


Figure O.2.5.1-1: Reference AUT Measurement Positions for distributed-axes system

The reference AUT positions inside a typical distributed-axes system are shown in Figure O.2.5.1-2.

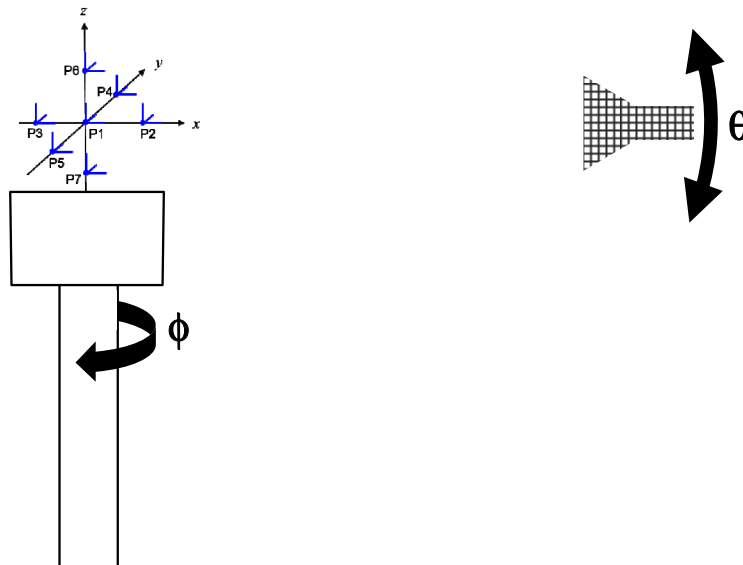


Figure O.2.5.1-2: Reference AUT Measurement Positions for distributed-axes system

### O.2.5.2 Combined-axes system

The reference AUT shall be positioned in a total of 7 different reference positions, shown in Figure O.2.5.2-1.



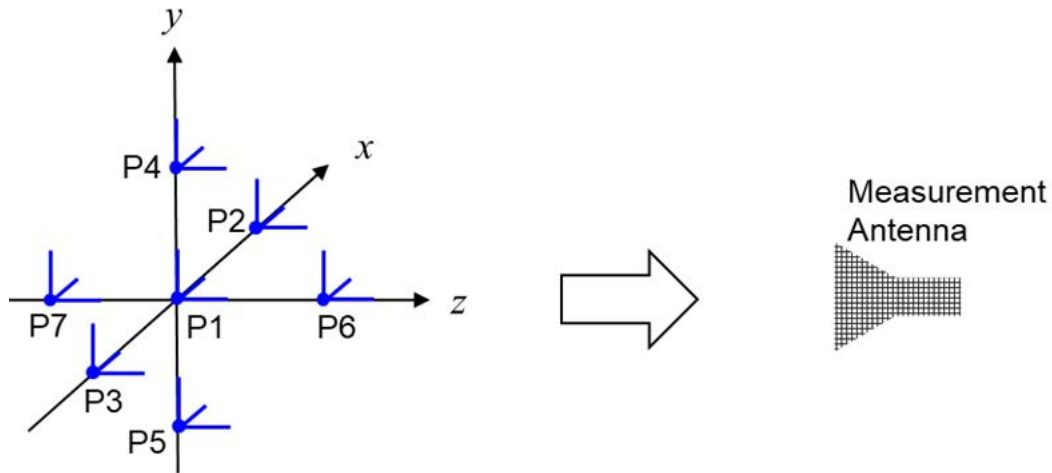


Figure O.2.5.2-1: Reference AUT Measurement Positions for combined-axes system

The reference AUT positions inside a typical combined-axes system are shown in Figure O.2.5.2-2.

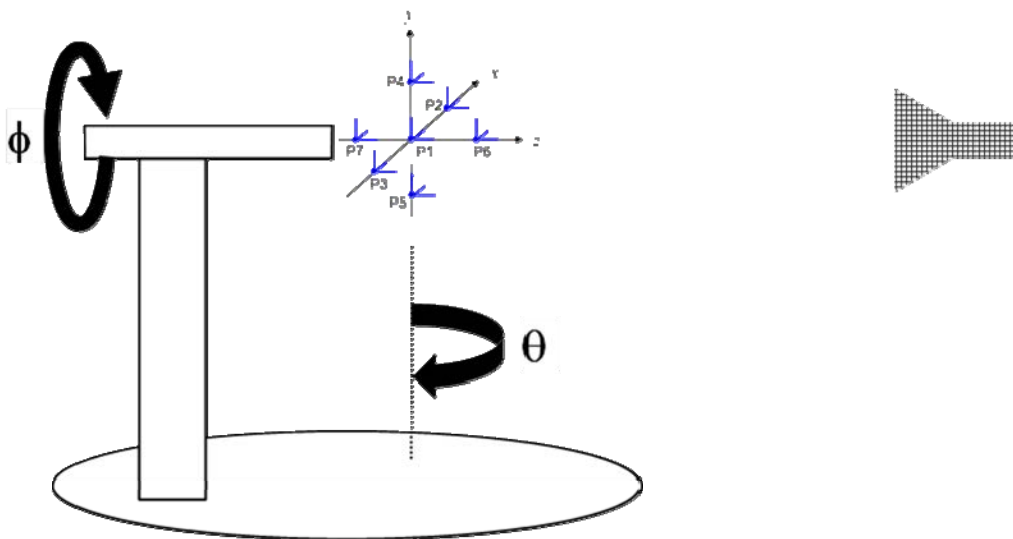


Figure O.2.5.2-2: Reference AUT Measurement Positions for combined-axes system

## O.2.6 Reference AUT orientations

As different areas within the chamber could yield variations in the field uniformity inside the quiet zone caused by reflections, it is important to characterize the electromagnetic fields with the reference antennas uniformly illuminating the anechoic chamber.

### O.2.6.1 Distributed-axes system

In order to keep the quality of the quiet zone characterization manageable in terms of test times, it is suggested to perform the reference measurements for the reference AUT placed at the 7 antenna positions with the antenna rotated around the y axis with 5 different angles  $\beta$ , i.e.,  $\beta = 0^\circ, 45^\circ, 90^\circ, 135^\circ,$  and  $180^\circ$ , and rotated around the z axis with 8 different  $\gamma = 0^\circ, 45^\circ, 90^\circ, 135^\circ, 180^\circ, 225^\circ, 270^\circ,$  and  $315^\circ$ . A graphical illustration of the some sample reference AUT orientations is shown in Figure O.2.6.1-1 with a reference AUT placed at position 6, P6, for reference antenna polarization  $\gamma_{\text{pol}} = 0^\circ$ ; Figure O.2.6.1-2 illustrates the reference AUT orientations for the reference polarization  $\gamma_{\text{pol}} = 90^\circ$ .

The matrix operation for the rotations and translation is defined as

$$M = T(t_x, t_y, t_z) \cdot R_z(\gamma) \cdot R_y(\beta) \cdot R_{z, pol}(\gamma_{pol})$$

for the distributed-axes system.

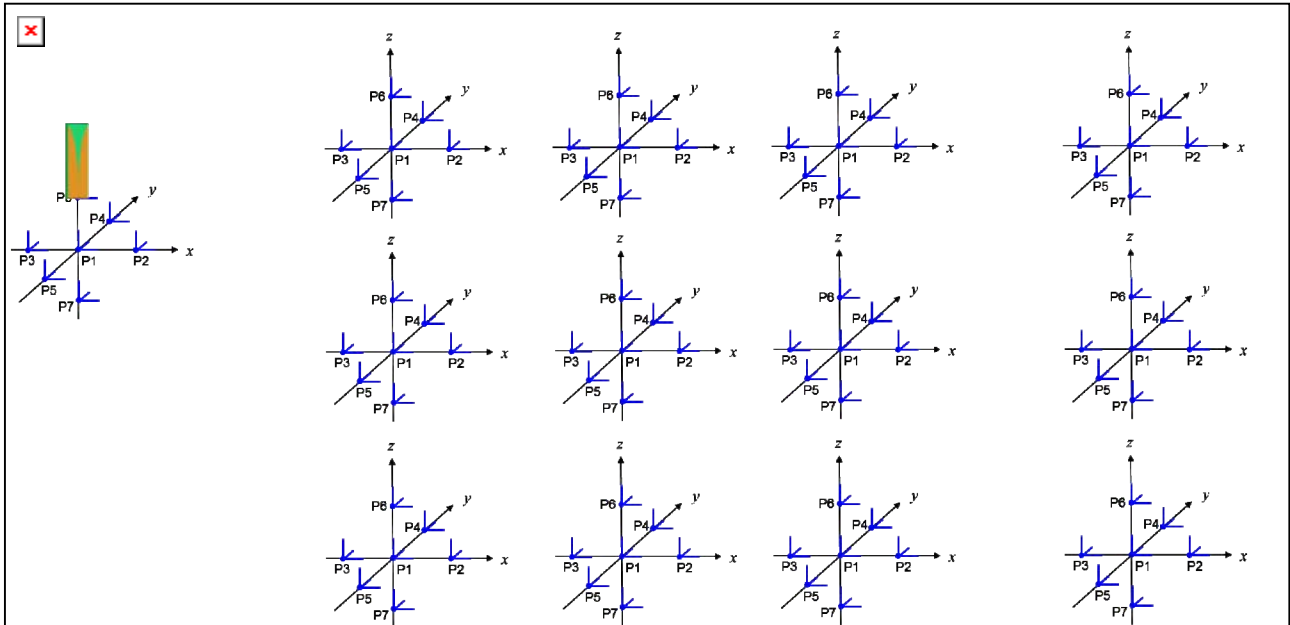


Figure O.2.6.1-1: Sample reference AUT orientations for position 6, P6 for reference antenna polarization  $\gamma_{pol} = 0^\circ$

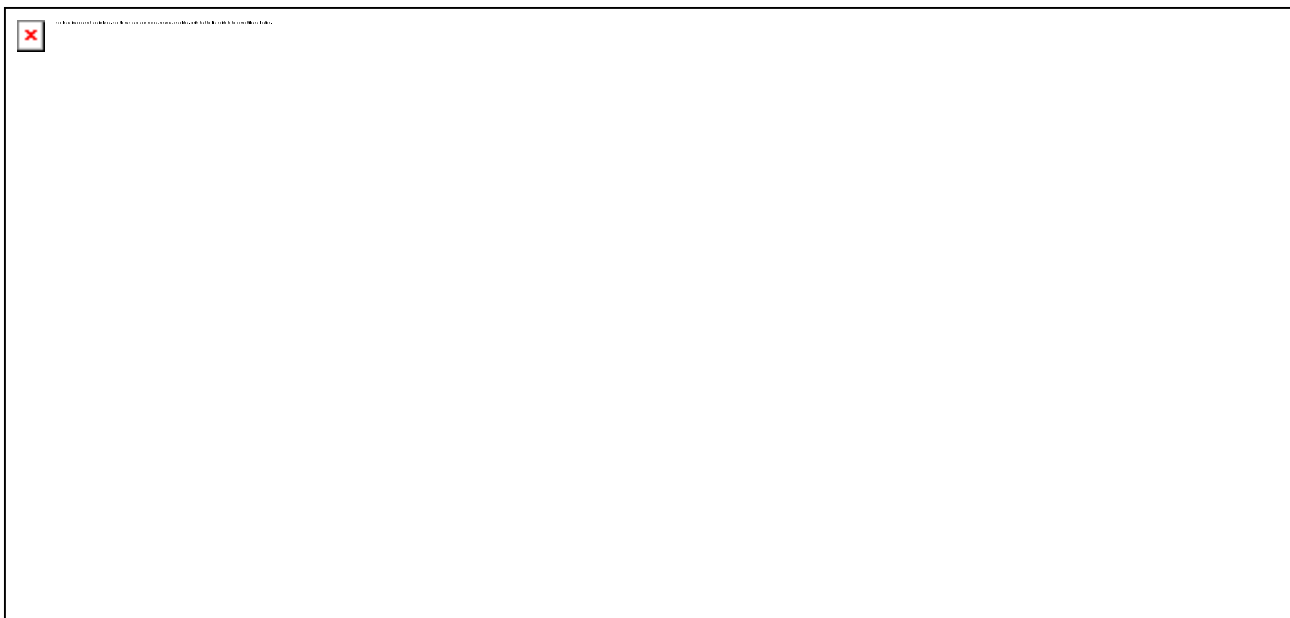


Figure O.2.6.1-2: Sample reference AUT orientations for position 6, P6, for reference antenna polarization  $\gamma_{pol} = 90^\circ$

When facing the z-axis,  $\beta = 0^\circ$  and  $\beta = 180^\circ$ , the antenna does not need to be evaluated for the 8 different rotations around the z axis. A single orientation is sufficient since those orientations are unique. Due to the pedestal, distributed-

axes systems are not able to measure towards the  $\beta = 180^\circ$  direction; for those systems, the reference measurements at this reference AUT orientation can be skipped.

If the device re-positioning approach outlined in Annex N is adopted for the EIRP/EIS/TRP based conformance test cases, the quality of quiet zone analysis is sufficient only for  $\beta = 0^\circ, 45^\circ, 90^\circ$ .

The positioner relative coordinates/orientations with respect to the measurement antenna/reflector in the initial position shall remain the same for each reference antenna orientation, e.g., in the sample distributed-axes system shown in Figure O.2.5.1-2 the reference antenna shall be pointed towards the positioner for  $\beta = 135^\circ$  for the initial position of  $(\theta, \phi)$  of  $(0, 0)$ .

### O.2.6.2 Combined-axes system

In order to keep the quality of the quiet zone characterization manageable in terms of test times, it is suggested to perform the reference measurements for the reference AUT placed at the 7 antenna positions with the antenna rotated around the x axis with 5 different angles  $\alpha$ , i.e.,  $\alpha = -90^\circ, -45^\circ, 0^\circ, 45^\circ$ , and  $90^\circ$  and rotated around the y axis with 8 different angles  $\beta = 0^\circ, 45^\circ, 90^\circ, 135^\circ, 180^\circ, 225^\circ, 270^\circ$ , and  $315^\circ$ . A graphical illustration of some sample reference AUT orientations is shown in Figure O.2.6.2-1 with a reference AUT placed at position 4, P4, for reference antenna polarization  $\gamma_{pol} = 0^\circ$ ; Figure O.2.6.2-2 illustrates the reference AUT orientations for the reference polarization  $\gamma_{pol} = 90^\circ$ .

The matrix operation for the rotations and translation is defined as

$$M = T(t_x, t_y, t_z) \cdot R_y(\beta) \cdot R_x(\alpha) \cdot R_{z,pol}(\gamma_{pol})$$

for the combined-axes system.

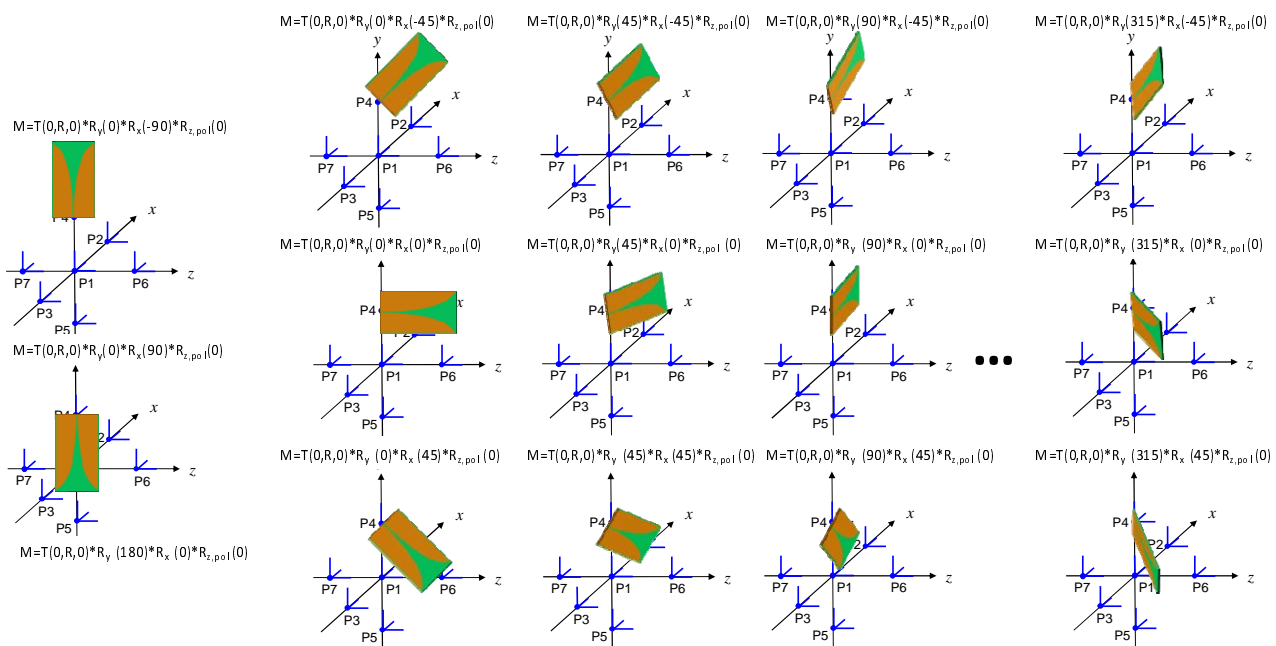
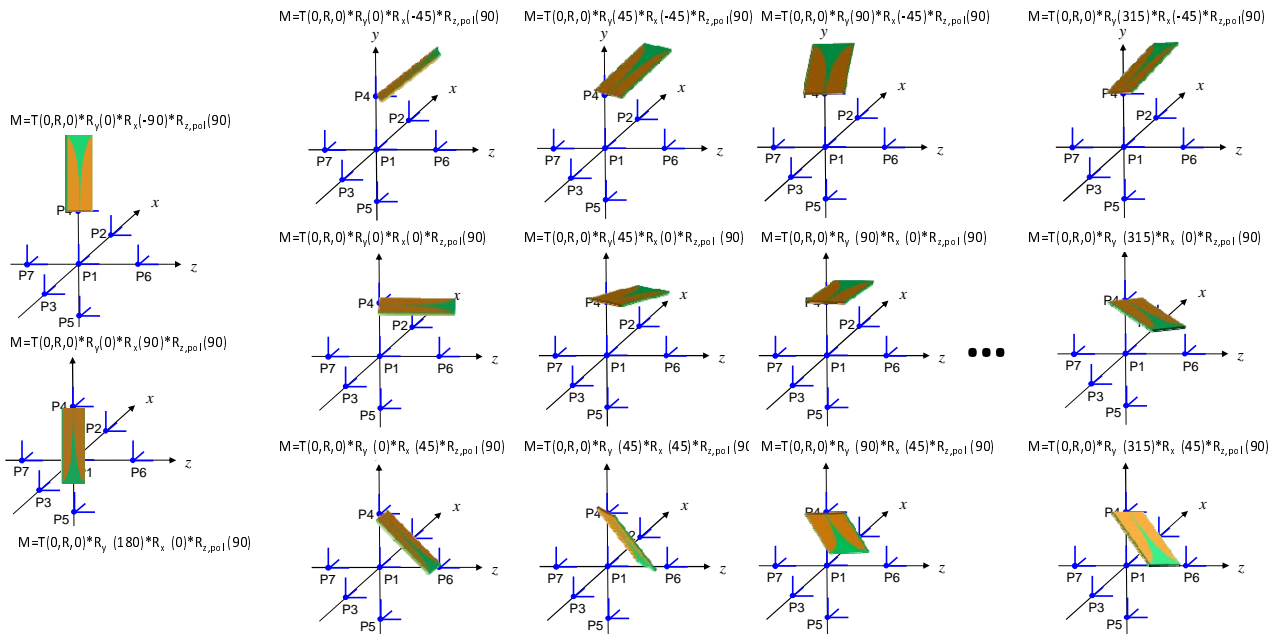


Figure O.2.6.2-1: Sample reference AUT orientations for position 4, P4, for reference antenna polarization  $\gamma_{pol} = 0^\circ$



**Figure O.2.6.2-2: Sample reference AUT orientations for position 4, P4, for reference antenna polarization  $\gamma_{pol} = 90^\circ$**

When facing the y axis,  $\alpha = 90^\circ$  and  $\alpha = -90^\circ$ , the antenna does not need to be evaluated for the 8 different rotations around the y axis. A single rotation is sufficient since those orientations are unique. Due to the pedestal of the 2-axis positioner, combined-axes systems are not able to measure towards the  $\beta = 180^\circ$  direction; for those systems, the reference measurements at this reference AUT orientation can be skipped.

If the device re-positioning approach outlined in Annex N is adopted for all EIRP/EIS/TRP based conformance test cases, the quality of quiet zone analysis is sufficient only for  $\beta = 0^\circ, 45^\circ, 90^\circ, 270^\circ$ , and  $315^\circ$ .

The positioner relative coordinates/orientations with respect to the measurement antenna/reflector shall remain the same for each reference antenna orientation, e.g., in the sample combined-axes system shown in O.2.5.2-2 the reference antenna shall be pointed towards the positioner for  $\beta = 135^\circ$  and  $225^\circ$  for the initial position of  $(\theta, \phi)$  of  $(0, 0)$ .

### O.2.7 Quality of quiet zone measurement uncertainty calculations for TRP

The combined MU element related to the quality of the quiet zone for TRP and offset between UE antenna array and centre of quiet zone is the standard deviation of the various efficiency measurement results that are based on the 7 different reference AUT positions, the respective reference AUT orientations, and the two reference AUT polarization orientations.

### O.2.8 Quality of quiet zone measurement uncertainty for EIRP/EIS

The MU for the quality of the quiet zone for EIRP/EIS includes the additional MU element of the directivity of the DUT and measurement antennas as shown in Figure O.2.9-1. The EIRP/EIS measurements are taking the peak gains of the respective antennas into account with the reference AUT placed in the centre of the quiet zone. Once the antenna is displaced in directions other than the measurement antenna, the direct line-of-sight link is taking reduced antenna gains into account. The type of reference AUT should therefore have similar pattern properties as typical UE antennas. For systems with very large range lengths, the directivity MU will be insignificant.

The combined MU element related to the quality of the quiet zone for EIRP/EIS, offset between UE antenna array and centre of quiet zone, and directivity is the standard deviation of the single-point gain measurement results that are based on the 7 different reference AUT positions, the respective reference AUT orientations, and the two reference AUT polarization orientations.

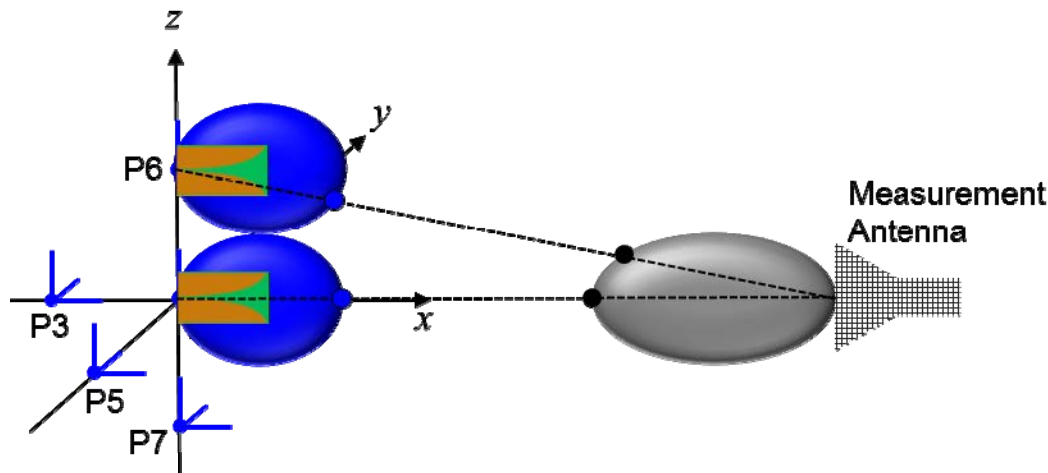


Figure O.2.9-1: Illustration of the Directivity MU Element

### O.3 Procedure to characterize the spurious emissions quality of the quiet zone for the permitted far field methods

This procedure is mandatory before the spurious emissions test system is commissioned for certification tests and characterizes the quiet zone performance of the anechoic chamber, specifically the effect of reflections within the anechoic chamber including any positioners and support structures. Additionally, it includes the effect of offsetting the directive antenna array inside a DUT from the centre of the quiet zone, i.e., the centre of rotation of the DUT and measurement antenna positioning systems.

The quiet zone is illustrated in Figure O.2-1 which includes the definitions of centre of quiet zone range, i.e., the geometric centre of the positioning systems, and the range length, i.e., the distance between the centre of the quiet zone and the aperture of the measurement antenna.

The outcome of the procedures can be used to predict the variation of the TRP measurements, spherical surface integrals of EIRP, when the DUT is placed anywhere within the quiet zone and with the beam formed in any arbitrary direction inside the chamber

The reference coordinate system defined in Annex N applies to this procedure.

#### O.3.1 Equipment used

The reference antenna under test (AUT) that is placed at various locations within the quiet zone shall be a directive antenna with a half-power beam width (HPBW) of  $\geq 20^\circ$  in E-Plane and H-Plane. The HPBWs met based on antenna vendors' calibration report or datasheet.

For the measurement, a combination of signal generator and spectrum analyser or a network analyser can be used. The multi-port (with three ports) network analyser is most suitable to reduce test time as both polarizations of the measurement antenna can be measured simultaneously, and multiple frequencies can be measured in a sweep.

#### O.3.2 Test frequencies

*Editor Note: Another test frequency of [TBD] GHz will be added as soon as FR2 bands >49 GHz are introduced.*

The frequencies to characterize the quality of the quiet zone shall be 6, 12.75, 23.45, 40.8, 49.0, 66, and 80 GHz. The quiet zone validation analysis is performed for each frequency individually.

The measurements from the 23.45, 40.8, and 49.0 GHz in-band QoQZ validation can be re-used provided that the reference antenna position and orientation as well as the measurement frequency and measurement antenna are identical in both cases.

### O.3.3 Reference measurements

The spurious emissions quality of the quiet zone measurements shall use 3D pattern measurements of the reference antenna patterns as they most closely resemble the 3D/spherical surface measurements/integrals of EIRP. Therefore, the quality of the quiet zone measurements for TRP metrics shall be based on efficiency measurements.

The grid types for the TRP measurements shall meet the 0.25 dB maximum standard uncertainty. The min number of grid points for the two grid types are:

- 192 grid points for the constant step-size measurement grids
- 100 grid points for the constant density measurement grids (charged particle implementation)

### O.3.4 Size of the quiet zone

The size of the quiet zone within which the variations of measurements are evaluated depends on the size of the DUT. For smartphones, the quiet zone shall be considered a sphere with radius of  $R=10\text{cm}$ . For larger smartphones and tablet type devices, the quiet zone shall be considered a sphere with radius of  $R=15\text{cm}$ . Alternate quiet zone sizes can be defined for even larger DUTs.

The quality of quiet zone procedure for systems supporting larger quiet zone sizes can be performed for the largest quiet zone radius only and the results can be applied to the smaller quiet zone radius. Performing separate sets of quality of quiet zone measurements for different radii is not precluded.

### O.3.5 Reference AUT positions

The reference AUT shall be positioned in a total of 7 different reference positions, shown in Figure O.2.5.1-1 and O.2.5.2-1

While position 1, P1, is the centre of the quiet zone, the remaining positions, 2 through 7, are off-centre positions each displaced by the radius of the quiet zone,  $R$ . The coordinates of the respective test points are shown in Table O.2.5-1.

#### O.3.5.1 Distributed-axes system

The reference AUT shall be positioned in a total of 7 different reference positions, shown in Figure O.2.5.1-1 for distributed-axes systems.

The reference AUT positions inside a typical distributed-axes system are shown in Figure O.2.5.1-2.

#### O.3.5.2 Combined-axes system

The reference AUT shall be positioned in a total of 7 different reference positions, shown in Figure O.2.5.2-1 for combined-axes systems.

The reference AUT positions inside a typical combined-axes system are shown in Figure O.2.5.2-2.

### O.3.6 Reference AUT orientations

As different areas within the chamber could yield variations in the field uniformity inside the quiet zone caused by reflections, it is important to characterize the electromagnetic fields with the reference antennas uniformly illuminating the anechoic chamber. However, in order to keep the spurious emissions quality of the quiet zone characterization manageable in terms of test time, the number of orientations for the spurious emissions quality of quiet zone validation is limited when compared to the number of orientations for the in-band quality of quiet zone validation.

#### O.3.6.1 Distributed-axes system

The reference measurements for the reference AUT placed at the 7 antenna positions shall be rotated around the  $y$  axis with 2 different angles  $\beta$ , i.e.,  $\beta = 0^\circ$  and  $180^\circ$  and fixed  $\gamma = 0^\circ$ . A graphical illustration of the reference AUT orientations is shown in Figure O.3.6.1-1 with a reference AUT placed at position 6, P6, for reference antenna

polarization  $\gamma_{pol} = 0^\circ$ ; Figure O.3.6.1-2 illustrates the reference AUT orientations for the reference polarization  $\gamma_{pol} = 90^\circ$ .

The matrix operation for the rotations and translation is defined as

$$M = T(t_x, t_y, t_z) \cdot R_z(\gamma) \cdot R_y(\beta) \cdot R_{z,pol}(\gamma_{pol})$$

for the distributed-axes system. The matrices are defined in Annex J.2 of TS 38.101-2.

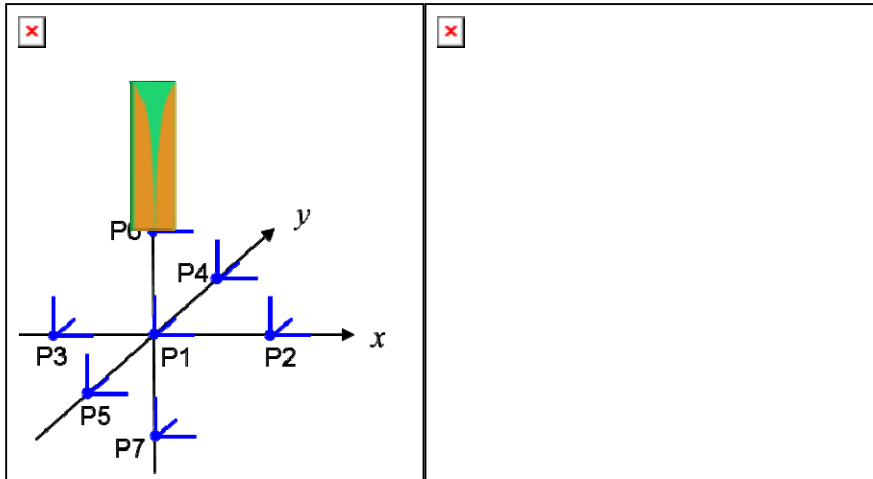


Figure O.3.6.1-1: Reference AUT orientations for position 6, P6 for reference antenna polarization  $\gamma_{pol} = 0^\circ$

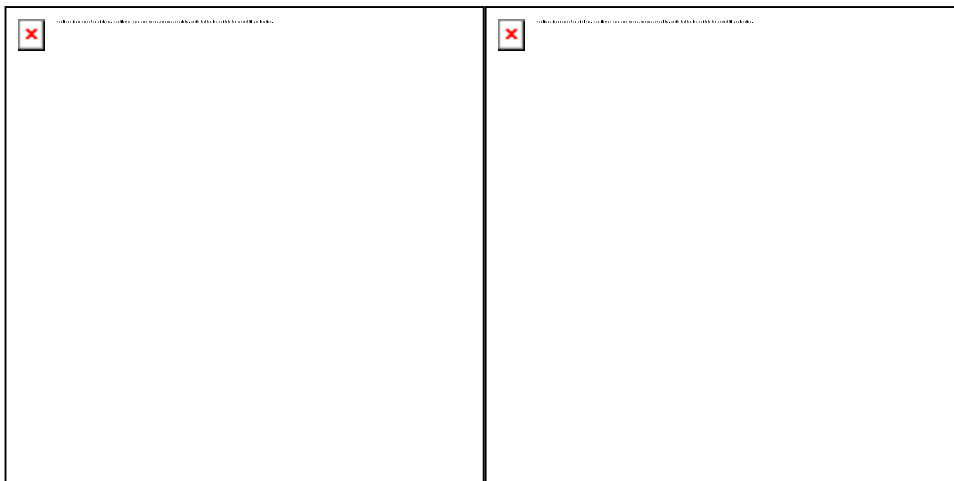


Figure O.3.6.1-2: Reference AUT orientations for position 6, P6, for reference antenna polarization  $\gamma_{pol} = 90^\circ$

If the device re-positioning approach is adopted for the spurious emissions test cases, i.e., two hemispheres are measured separately which involves the DUT, while connected to the gNB emulator, to be rotated by  $180^\circ$  around its axis halfway through the test, the quality of quiet zone analysis is sufficient only for  $\beta = 0^\circ$ .

The positioner relative coordinates/orientations with respect to the measurement antenna/reflector in the initial position shall remain the same for each reference antenna orientation, e.g., in the sample distributed-axes system shown in Figure O.2.5.1-2 the reference antenna shall be pointed at the positioner for  $\beta = 180^\circ$  for the initial position of  $(\theta, \phi)$  of  $(0, 0)$ .

### O.3.6.2 Combined-axes system

The reference measurements for the reference AUT placed at the 7 antenna positions shall be rotated around the  $x$  axis with 2 different angles  $\beta$ , i.e.,  $\beta = 0^\circ$  and  $180^\circ$  and fixed  $\alpha = 0^\circ$ . A graphical illustration of the sample reference AUT orientations is shown in Figure O.3.6.2-1 with a reference AUT placed at position 4, P4, for reference antenna polarization  $\gamma_{pol} = 0^\circ$ ; Figure O.3.6.2-2 illustrates the reference AUT orientations for the reference polarization  $\gamma_{pol} = 90^\circ$ .

The matrix operation for the rotations and translation is defined as

$$M = T(t_x, t_y, t_z) \cdot R_y(\beta) \cdot R_x(\alpha) \cdot R_{z,pol}(\gamma_{pol})$$

for the combined-axes system. The matrices are defined in Annex J.2 of TS 38.101-2.

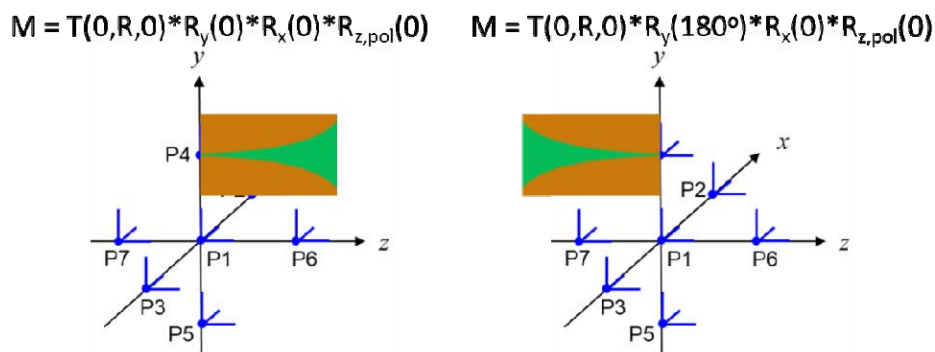


Figure O.3.6.2-1: Reference AUT orientations for position 4, P4, for reference antenna polarization  $\gamma_{pol} = 0^\circ$ .

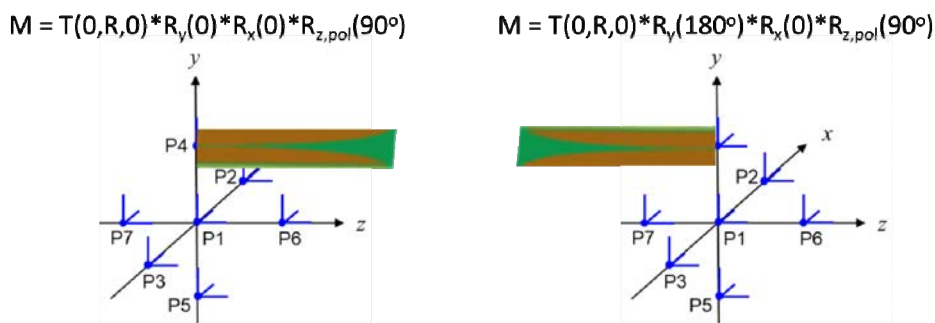


Figure O.3.6.2-2: Reference AUT orientations for position 4, P4, for reference antenna polarization  $\gamma_{pol} = 90^\circ$ .

If the device re-positioning approach is adopted for the spurious emissions test cases, i.e., two hemispheres are measured separately which involves the DUT, while connected to the gNB emulator, to be rotated by  $180^\circ$  around its axis halfway through the test, the quality of quiet zone analysis is sufficient only for  $\beta = 0^\circ$ .

The positioner relative coordinates/orientations with respect to the measurement antenna/reflector shall remain the same for each reference antenna orientation, e.g., in the sample combined-axes system shown in O.2.5.2-2 the reference antenna shall be pointed at the positioner for  $\beta = 180^\circ$  for the initial position of  $(\theta, \phi)$  of  $(0, 0)$ .

### O.3.7 Quality of quiet zone measurement uncertainty calculations for TRP

The combined MU element related to the spurious emissions quality of the quiet zone for TRP and offset between UE antenna array and centre of quiet zone is the standard deviation of the various efficiency measurement results that are



based on the 7 different reference AUT positions, the respective reference AUT orientations, and the two reference AUT polarization orientations.

## Annex P (normative): Modified MPR behaviour

### P.1 Indication of modified MPR behaviour

This annex contains the definitions of the bits in the field *modifiedMPR-Behavior* indicated per supported NR band in the IE *RF-Parameters* [19] by a UE supporting an MPR or A-MPR modified in a given version of this specification. A modified MPR or A-MPR behaviour can apply to a supported NR band in stand-alone operation (including CA and NN-DC operation) or in non-standalone operation with the said NR band as part of an EN-DC or NE-DC band combination. Moreover, the bits in the field can explicitly indicate NS value(s) supported by a UE.

NOTE 1: In the present release, the *modifiedMPR-Behavior* is indicated [19] by an 8-bit bitmap per supported NR band.

**Table P.1-1: Definitions of the bits in the field *modifiedMPRbehavior***

NR Band	Index of field (bit number)	Definition (description of the supported functionality if indicator set to one)	Notes
n257	0 (leftmost bit)	- FR2 power class 3 MPR as defined in clause 6.2.2.3 of 38.101-2 v16.2.0	- This bit may be set to 1 by a UE supporting n257
n258	0 (leftmost bit)	- FR2 power class 3 MPR as defined in clause 6.2.2.3 of 38.101-2 v16.2.0	- This bit may be set to 1 by a UE supporting n258
	1	Void	
	2	- NS_203 as defined in clause 6.5.3.2.4 or both NS_203 and CA_NS_203 as defined in clause 6.5A.3.2.4 of 38.101-2 v15.11.0	- This bit shall be set to 1 by a UE supporting n258 or both n258 and CA_n258
n260	0 (leftmost bit)	- FR2 power class 3 MPR as defined in clause 6.2.2.3 of 38.101-2 v16.2.0	- This bit may be set to 1 by a UE supporting n260
n261	0 (leftmost bit)	- FR2 power class 3 MPR as defined in clause 6.2.2.3 of 38.101-2 v16.2.0	- This bit may be set to 1 by a UE supporting n261

## Annex Q (informative): Change history

Change history							
Date	Meeting	TDoc	CR	R ev	Cat	Subject/Comment	New version
2017-08	RAN5 #76	R5-174709	-	-	-	Draft skeleton	0.0.1
2018-01	RAN5#1-5G-NR Adhoc	R5-180002	-	-	-	Add references	0.1.0
2018-01	RAN5#1-5G-NR Adhoc	R5-180103	-	-	-	Add definitions, symbols and abbreviations	0.1.0
2018-01	RAN5#1-5G-NR Adhoc	R5-180104	-	-	-	Introduction of Operating bands and Channel arrangement	0.1.0
2018-01	RAN5#1-5G-NR Adhoc	R5-180094	-	-	-	Introduction of new test case 6.3.2 Transmit OFF power	0.1.0
2018-01	RAN5#1-5G-NR Adhoc	R5-180095	-	-	-	TP to add skeleton of 6.5.1 Occupied bandwidth to 38.521-2	0.1.0
2018-01	RAN5#1-5G-NR Adhoc	R5-180096	-	-	-	TP to add skeleton of 6.5.2.1 SEM to 38.521-2	0.1.0
2018-01	RAN5#1-5G-NR Adhoc	R5-180097	-	-	-	TP to add skeleton of 6.5.2.3 ACLR to 38.521-2	0.1.0
2018-03	RAN5 #78	R5-181508	-	-	-	Updated 38.521-2 to extend Annex with additional testing information	0.2.0
2018-03	RAN5 #78	R5-181680	-	-	-	TP to skeleton of 7.6.1 Inband blocking to 38.521-2	0.2.0
2018-03	RAN5 #78	R5-181681	-	-	-	5G-NR: Text Proposal to add spurious emissions test case to 38.521-2	0.2.0
2018-04	RAN5#2-5G-NR Adhoc	R5-181978	-	-	-	Update TS 38.521-2 further to align with the latest TS 38.101-2 spec structure.	0.3.1
2018-04	RAN5#2-5G-NR Adhoc	R5-182027	-	-	-	5G-NR Text Proposal to update spurious emissions test case to 38.521-2	0.4.0
2018-04	RAN5#2-5G-NR Adhoc	R5-182041	-	-	-	5G-NR Text Proposal to add REFSENS test case to 38.521-2	0.4.0
2018-04	RAN5#2-5G-NR Adhoc	R5-182009	-	-	-	General section updated to 38.521-2	0.4.0
2018-04	RAN5#2-5G-NR Adhoc	R5-182048	-	-	-	Addition of FR2 test case 6.3.1 Minimum Output Power	0.4.0
2018-04	RAN5#2-5G-NR Adhoc	R5-182049	-	-	-	Addition of FR2 test case 6.3.3.2 General ON/OFF time mask	0.4.0
2018-04	RAN5#2-5G-NR Adhoc	R5-181839	-	-	-	Definitions and abbreviations updated to 38.521-2	0.4.0
2018-04	RAN5#2-5G-NR Adhoc	R5-181840	-	-	-	Operating bands and Channel arrangement updated to 38.521-2	0.4.0
2018-04	RAN5#2-5G-NR Adhoc	R5-182008	-	-	-	Introduction of new test case 7.4 Maximum input level	0.4.0
2018-04	RAN5#2-5G-NR Adhoc	R5-182010	-	-	-	Common uplink configuration table for Tx test cases for TS 38.521-2 non-CA	0.4.0
2018-04	RAN5#2-5G-NR Adhoc	R5-182011	-	-	-	TP for 6.5.1 Occupied Bandwidth in TS 38.521-2	0.4.0
2018-04	RAN5#2-5G-NR Adhoc	R5-182029	-	-	-	TP for 6.5.2.1 Spectrum Emission Mask in TS 38.521-2	0.4.0
2018-04	RAN5#2-5G-NR	R5-182031	-	-	-	TP for 6.5.2.3 Adjacent Channel Leakage Ratio in TS 38.521-2	0.4.0

	Adhoc						
2018-04	RAN5#2-5G-NR Adhoc	R5-182043	-	-	-	TP for 7.6.2 InBand Blocking in TS 38.521-2	0.4.0
2018-04	RAN5#2-5G-NR Adhoc	R5-182046	-	-	-	TP for 7.5 Adjacent channel selectivity in TS 38.521-2	0.4.0
2018-04	RAN5#2-5G-NR Adhoc	R5-181844	-	-	-	Add Annex G (normative): Measurement uncertainties and Test Tolerances	0.4.0
2018-04	RAN5#2-5G-NR Adhoc	R5-181844	-	-	-	Add clause 4.4 Test point analysis	0.4.0
2018-05	RAN5 #79	R5-183908	-	-	-	Introduction of New FR2 test case 6.3.3.4 PRACH time mask	0.5.0
2018-05	RAN5 #79	R5-182769	-	-	-	General section updated to 38.521-2	0.5.0
2018-05	RAN5 #79	R5-183914	-	-	-	TP for FR2 spurious test procedure (38.521-2)	0.5.0
2018-05	RAN5 #79	R5-183925	-	-	-	Update of Refsens test procedure for FR2	0.5.0
2018-05	RAN5 #79	R5-182883	-	-	-	Definitions, symbols and abbreviations updated to 38.521-2	0.5.0
2018-05	RAN5 #79	R5-182884	-	-	-	Operating bands and Channel arrangement updated to 38.521-2	0.5.0
2018-05	RAN5 #79	R5-182890	-	-	-	Update minimum conformance requirements and test requirement for 6.3.2 Transmit OFF power	0.5.0
2018-05	RAN5 #79	R5-183926	-	-	-	Annex for test case applicability per permitted test method	0.5.0
2018-05	RAN5 #79	R5-183712	-	-	-	Corrections annexes for EIRP and TRP metric definition	0.5.0
2018-05	RAN5 #79	R5-183927	-	-	-	Clean up TBD from Occupied Bandwidth, SEM and ACLR test cases	0.5.0
2018-05	RAN5 #79	R5-183928	-	-	-	Clean up TBD from ACS and Inband Blocking test cases	0.5.0
2018-05	RAN5 #79	R5-183948	-	-	-	Statistical Testing Annex for 38.521-2	0.5.0
2018-08	RAN5 #80	R5-185348	-	-	-	Correction to FR2 Spurious TC and introduction of TRP measurement grid requirement	1.0.0
2018-08	RAN5 #80	R5-185350	-	-	-	Addition of Frequency Error test case to TS 38.521-2	1.0.0
2018-08	RAN5 #80	R5-185490	-	-	-	FR2_TxSpurious_TestConfig_38.521-2	1.0.0
2018-08	RAN5 #80	R5-185562	-	-	-	FR2_StoreTxRxBeamPeakCoordinates_38.521-2	1.0.0
2018-08	RAN5 #80	R5-184742	-	-	-	Update of FR2 test case 6.3.1	1.0.0
2018-08	RAN5 #80	R5-184743	-	-	-	Update of FR2 test case 6.3.3.2	1.0.0
2018-08	RAN5 #80	R5-184856	-	-	-	General sections updated to 38.521-2	1.0.0
2018-08	RAN5 #80	R5-185519	-	-	-	Updates of FR2 TRx MU and TT in Annex	1.0.0
2018-08	RAN5 #80	R5-185555	-	-	-	FR2_UE_BeamlockInvoke_38.521-2	1.0.0
2018-08	RAN5 #80	R5-185191	-	-	-	Update to Occupied Bandwidth, SEM and ACLR test cases in TS 38.521-2	1.0.0
2018-08	RAN5 #80	R5-185192	-	-	-	Update to ACS and inband blocking test cases in TS 38.521-2	1.0.0
2018-08	RAN5 #80	R5-185187	-	-	-	FR2_RefSens_TestConfig_38.521-2	1.0.0
2018-08	RAN5 #80	R5-185188	-	-	-	DL and UL RMC updated for FR2 tests	1.0.0
2018-08	RAN5 #80	R5-185189	-	-	-	Downlink physical channel updated for FR2 tests	1.0.0
2018-08	RAN5 #80	R5-185190	-	-	-	OCNG Patterns updated for FR2 tests	1.0.0
2018-08	RAN5 #80	R5-185194	-	-	-	Update to Test frequencies for SEM in TS 38.521-2	1.0.0
2018-08	RAN5 #80	R5-185196	-	-	-	Addition of Carrier Leakage test case to TS 38.521-2	1.0.0
2018-08	RAN5 #80	R5-185193	-	-	-	Addition of Annex Global In-Channel TX-Test to 38.521-2	1.0.0
2018-08	RAN5 #80	R5-185197	-	-	-	Introduction of maximum output power test cases	1.0.0
2018-08	RAN5 #80	R5-185195	-	-	-	Addition of EVM test case to TS 38.521-2	1.0.0
2018-09	RAN #81	-	-	-	-	raised to v15.0.0 with editorial changes only	15.0.0
2018-12	RAN #82	R5-186504	0021	-	F	FR2 RefSens test case updates	15.1.0
2018-12	RAN #82	R5-186505	0022	-	F	Update Text on Store Beam Peak Coordinate	15.1.0
2018-12	RAN #82	R5-186510	0023	-	F	Structure updates to Annex C and G	15.1.0
2018-12	RAN #82	R5-186675	0026	-	F	Updating test case 6.2.3 maximum output power with additional requirements	15.1.0
2018-12	RAN #82	R5-187151	0034	-	F	Updated to Annexes for FR2 tests	15.1.0
2018-12	RAN #82	R5-187152	0035	-	F	General Information updated for TS38.521-2	15.1.0
2018-12	RAN #82	R5-187561	0042	-	F	Update to Table 5.3.5-1 in TS 38.521-2	15.1.0
2018-12	RAN #82	R5-187619	0050	-	F	Update of Section 6.3.3.1 General	15.1.0
2018-12	RAN #82	R5-187838	0045	1	F	Update of transmit signal quality test cases in 38.521-2	15.1.0
2018-12	RAN #82	R5-187839	0046	1	F	Addition of In-band Emissions test case to TS 38.521-2	15.1.0
2018-12	RAN #82	R5-187840	0047	1	F	Addition of EVM equalizer spectral flatness test cases 6.4.2.4 and 6.4.2.5 to TS 38.521-2	15.1.0
2018-12	RAN #82	R5-187841	0048	1	F	Update of Common Uplink Configuration for FR2	15.1.0
2018-12	RAN #82	R5-187842	0029	1	F	General sections updated to 38.521-2	15.1.0
2018-12	RAN #82	R5-187843	0044	1	F	Update of Global In-channel Tx Test Annex in 38.521-2	15.1.0
2018-12	RAN #82	R5-187886	0020	1	F	FR2 Spurious Emission test case updates	15.1.0
2018-12	RAN #82	R5-187912	0038	1	F	Addition of notes to clarify test point selection into general section of TS 38.521-2	15.1.0
2018-12	RAN #82	R5-188037	0032	1	F	Removing the Editor's notes of SA messages and procedures for all FR2 test cases	15.1.0
2018-12	RAN #82	R5-188038	0036	1	F	FR2 downlink signal level(38.521-2)	15.1.0
2018-12	RAN #82	R5-188063	0027	1	F	Update of FR2 6.3.2 Transmit OFF power	15.1.0

2018-12	RAN #82	R5-188212	0040	2	F	Updates to maximum output power test cases	15.1.0
2018-12	RAN #82	R5-188213	0028	1	F	Update of FR2 test case 7.4	15.1.0
2018-12	RAN #82	R5-188214	0025	1	F	Updates of TT in TS 38.521-2 Annex F during RAN5#81	15.1.0
2018-12	RAN #82	R5-188215	0031	1	F	TDD configuration for UE Tx test in FR2	15.1.0
2018-12	RAN #82	R5-188216	0039	1	F	Core alignment CR to capture TS 38.101-2 updates during RAN4#89	15.1.0
2018-12	RAN #82	R5-188217	0041	2	F	On measurement grids	15.1.0
2018-12	RAN #82	R5-188218	0043	1	F	Update to Annex K	15.1.0
2018-12	RAN #82	RP-182736	0024	2	F	Updates of MU Annex F	15.1.0
2019-03	RAN #83	R5-191091	0083	-	F	Updates of TT in TS38.521-2 Annex F during RAN5#NR4	15.2.0
2019-03	RAN #83	R5-191092	0084	-	F	Editorial correction of core alignment in TS 38.521-2	15.2.0
2019-03	RAN #83	R5-191093	0085	-	F	Editorial cleaning up of test configuration tables in TS 38.521-2	15.2.0
2019-03	RAN #83	R5-191246	0086	-	F	Update TRP measurement procedure Annex in TS38.521-2	15.2.0
2019-03	RAN #83	R5-191247	0087	-	F	Update Annex K and Annex M in TS38.521-2	15.2.0
2019-03	RAN #83	R5-191259	0088	-	F	Update to FR2 test case 6.3.3.4 PRACH time mask	15.2.0
2019-03	RAN #83	R5-191507	0090	-	F	Shared Risk clarification in TS 38.521-2	15.2.0
2019-03	RAN #83	R5-191609	0093	-	F	CR to TS 38.521-2 to add text proposal for Annex F.1	15.2.0
2019-03	RAN #83	R5-191676	0094	-	F	Addition of FR2 6.2.4 Configured transmitted power	15.2.0
2019-03	RAN #83	R5-191677	0095	-	F	Update of FR2 6.3.1 Minimum Output Power	15.2.0
2019-03	RAN #83	R5-191679	0096	-	F	Addition of FR2 6.3.4.2 Absolute power tolerance	15.2.0
2019-03	RAN #83	R5-191680	0097	-	F	Update of FR2 6.3.3.2 General ON/OFF time mask	15.2.0
2019-03	RAN #83	R5-191793	0098	-	F	Introduction of Minimum output power for 2UL CA	15.2.0
2019-03	RAN #83	R5-191809	0099	-	F	OBW test procedure update for 38.521-2	15.2.0
2019-03	RAN #83	R5-191812	0100	-	F	FR2 Spurious Emission test case updates	15.2.0
2019-03	RAN #83	R5-191824	0102	-	F	Update to Annex K and Annex L	15.2.0
2019-03	RAN #83	R5-191986	0107	-	F	Introduction of Annex on Characteristics of the Interfering Signal FR2	15.2.0
2019-03	RAN #83	R5-192092	0110	-	F	Test mode and test loop function activation in SA Tx RF test cases in TS 38.521-2	15.2.0
2019-03	RAN #83	R5-192095	0111	-	F	Test mode and test loop function activation in SA Rx RF test cases in TS 38.521-2	15.2.0
2019-03	RAN #83	R5-192122	0112	-	F	Update of Global In-channel Tx Test Annex for FR2	15.2.0
2019-03	RAN #83	R5-192450	0089	1	F	Update of test case 6.3.4.3, Relative power tolerance in 38.521-2	15.2.0
2019-03	RAN #83	R5-192451	0082	1	F	Updates of test environment for frequency error	15.2.0
2019-03	RAN #83	R5-192452	0105	1	F	FR2 SA Spurious Emission Coexistence test case	15.2.0
2019-03	RAN #83	R5-192648	0106	1	F	Introduction of Aggregate power tolerance in NR SA FR2	15.2.0
2019-03	RAN #83	R5-192649	0117	1	F	CR to add UL RMC for 60kHz SCS in Annex A.2.3	15.2.0
2019-03	RAN #83	R5-192650	0113	1	F	Update of transmit signal quality test cases for FR2	15.2.0
2019-03	RAN #83	R5-192651	0114	1	F	Update OBW test case in TS 38.521-2	15.2.0
2019-03	RAN #83	R5-192652	0115	1	F	Update SEM test case in TS 38.521-2	15.2.0
2019-03	RAN #83	R5-192653	0116	1	F	Update ACLR test case in TS 38.521-2	15.2.0
2019-03	RAN #83	R5-192654	0101	1	F	FR2 Reference Sensitivity test case updates	15.2.0
2019-03	RAN #83	R5-192655	0104	1	F	FR2 Reference Sensitivity EIS spherical coverage	15.2.0
2019-03	RAN #83	R5-192667	0108	1	F	Update of Annex F.2	15.2.0
2019-03	RAN #83	R5-192849	0080	2	F	Updates of MU in TS38.521-2 Annex F during RAN5#82	15.2.0
2019-03	RAN #83	R5-192843	0081	2	F	Updates of TT in TS38.521-2 Annex F during RAN5#82	15.2.0
2019-03	RAN #83	R5-192680	0103	1	F	38.521-2 Editor's Note Updates	15.2.0
2019-03	RAN #83	RP-190746	0118	4	F	Updates to maximum output power test cases	15.2.0
2019-03	RAN#83	-	-	-	-	Editorial correction of references to TS 38.508-1 clause 4.6 tables	15.2.0
2019-06	RAN#84	R5-193541	0137	-	F	Alignment of scheduling of DL RMC with scheduling of UL RMC	15.3.0
2019-06	RAN#84	R5-193552	0138	-	F	Core alignment of RAN4 pending issues in TS 38.521-2	15.3.0
2019-06	RAN#84	R5-193575	0143	-	F	Correction of 38.521-2 7.4	15.3.0
2019-06	RAN#84	R5-193749	0151	-	F	Updates of ACLR test procedure	15.3.0
2019-06	RAN#84	R5-193820	0152	-	F	Correction of 38.521-2 clause 2 to 5	15.3.0
2019-06	RAN#84	R5-194009	0153	-	F	FR2 Reference Sensitivity test case updates	15.3.0
2019-06	RAN#84	R5-194243	0161	-	F	Addition FR2 blocking measurement procedure in Annex K	15.3.0
2019-06	RAN#84	R5-194264	0163	-	F	Correction to FR2 EIRP test configurations	15.3.0
2019-06	RAN#84	R5-194265	0164	-	F	Correction to FR2 EIS test configurations	15.3.0
2019-06	RAN#84	R5-194269	0165	-	F	Update FR2 ACS and Inband blocking test cases	15.3.0
2019-06	RAN#84	R5-194461	0170	-	F	Update to 6.2.3 A-MPR FR2	15.3.0
2019-06	RAN#84	R5-194618	0171	-	F	Update of Global In-channel Tx Test Annex for FR2	15.3.0
2019-06	RAN#84	R5-194958	0139	1	F	Updates of MU and TT in TS 38.521-2 Annex F during RAN5#NR5	15.3.0
2019-06	RAN#84	R5-194968	0167	1	F	Update of TC 6.3A.1.1 Minimum output power for 2UL CA	15.3.0
2019-06	RAN#84	R5-194969	0166	1	F	Clean up FR2 SA test cases	15.3.0
2019-06	RAN#84	R5-194970	0160	1	F	Introduction of beam correspondence	15.3.0
2019-06	RAN#84	R5-194971	0162	1	F	Introduction of beam correspondence for CA	15.3.0
2019-06	RAN#84	R5-194976	0173	1	F	Update of Frequency Error Test Case for FR2	15.3.0
2019-06	RAN#84	R5-194977	0175	1	F	Editorial corrections for 6.2.1 UE maximum output power	15.3.0
2019-06	RAN#84	R5-195080	0176	-	F	Update of FR2 ON_ON time mask test cases	15.3.0
2019-06	RAN#84	R5-195147	0141	1	F	Addition of new SA FR2 RF test case 6.2.2	15.3.0
2019-06	RAN#84	R5-195149	0142	1	F	Correction of 38.521-2 6.3.2	15.3.0

2019-06	RAN#84	R5-195151	0144	1	F	Introduction of MOP (SA UL CA)	15.3.0
2019-06	RAN#84	R5-195152	0145	1	F	Introduction of OFF power (SA UL CA)	15.3.0
2019-06	RAN#84	R5-195153	0146	1	F	Introduction of Frequency error (SA UL CA)	15.3.0
2019-06	RAN#84	R5-195154	0148	1	F	Introduction of SEM (SA UL CA)	15.3.0
2019-06	RAN#84	R5-195155	0149	1	F	Introduction of ACLR (SA UL CA)	15.3.0
2019-06	RAN#84	R5-195156	0150	1	F	Introduction of General Spurious (SA UL CA)	15.3.0
2019-06	RAN#84	R5-195157	0157	1	F	Introduction of New test case 6.5A.1.1 Occupied bandwidth for CA (2UL CA)	15.3.0
2019-06	RAN#84	R5-195158	0156	1	F	Update Out of band emission test cases in TS 38.521-2	15.3.0
2019-06	RAN#84	R5-195160	0159	1	F	Introduction of SRS time mask for UL-MIMO	15.3.0
2019-06	RAN#84	R5-195404	0172	1	F	Update of transmit signal quality test cases for FR2	15.3.0
2019-06	RAN#84	R5-195417	0154	1	F	38.521-2 implementation of FR2 UL demod OTA tests using single pol Rx TE	15.3.0
2019-06	RAN#84	R5-195432	0168	2	F	Update to 6.2.1.1 UE maximum output power - EIRP and TRP	15.3.0
2019-06	RAN#84	R5-195433	0169	2	F	Update to 6.2.1.2 UE maximum output power - Spherical coverage	15.3.0
2019-06	RAN#84	R5-195434	0140	1	F	Updates of MU and TT in TS 38.521-2	15.3.0
2019-06	RAN#84	R5-195435	0155	1	F	Core alignment with TS 38.101-2	15.3.0
2019-06	RAN#84	-	-	-	-	Administrative release upgrade to match the release of 3GPP TS 38.508-1 and TS 38.521-1 which were upgraded at RAN#84 to Rel-16 due to Rel-16 relevant CR(s)	16.0.0
2019-09	RAN#85	R5-195695	0178	-	F	Change of TS 38.521-2 UL CA MOP Minimum conformance requirements	16.1.0
2019-09	RAN#85	R5-196069	0194	-	F	Introduction of absolute power tolerance for CA test cases	16.1.0
2019-09	RAN#85	R5-196165	0198	-	F	Correction of wrong spec reference numbers for TS 38.508-1	16.1.0
2019-09	RAN#85	R5-196236	0202	-	F	Correction to test procedure of TC 6.4.2.2 Carrier Leakage	16.1.0
2019-09	RAN#85	R5-196240	0206	-	F	Clarification on EVM test requirement for PUCCH and PRACH	16.1.0
2019-09	RAN#85	R5-196427	0208	-	F	Update of FR2 6.2.4 Configured transmitted power	16.1.0
2019-09	RAN#85	R5-196428	0209	-	F	Update of FR2 6.3.3.2 General ON_OFF time mask	16.1.0
2019-09	RAN#85	R5-196431	0211	-	F	Addition of FR2 6.2A.4 Configured transmitted power for 2UL CA	16.1.0
2019-09	RAN#85	R5-196433	0213	-	F	Addition of FR2 6.2D.4 Configured transmitted power for UL MIMO	16.1.0
2019-09	RAN#85	R5-196434	0214	-	F	Addition of FR2 6.3D.1 Minimum output power for UL MIMO	16.1.0
2019-09	RAN#85	R5-196594	0220	-	F	Addition of new test case 6.4A.2.1.2 Error vector magnitude for 3UL CA in FR2	16.1.0
2019-09	RAN#85	R5-196595	0221	-	F	Addition of new test case 6.4A.2.1.3 Error vector magnitude for 4UL CA in FR2	16.1.0
2019-09	RAN#85	R5-196650	0225	-	F	Update of Minimum conformance requirements and test configurations in TC 6.2.2	16.1.0
2019-09	RAN#85	R5-196810	0229	-	F	Update to TRP measurement grid section in TS 38.521-2	16.1.0
2019-09	RAN#85	R5-196950	0239	-	F	Corrections on clause 2 and 3 in 38.521-2	16.1.0
2019-09	RAN#85	R5-197384	0197	1	F	Update UL-MIMO to UL MIMO to align with RAN4 terminology in FR2	16.1.0
2019-09	RAN#85	R5-197385	0238	1	F	Update OBW FR2 test case	16.1.0
2019-09	RAN#85	R5-197386	0200	1	F	Alignment of clause 2 to 5 with the core spec	16.1.0
2019-09	RAN#85	R5-197387	0242	-	F	Integrating the QoQZ Procedures into 38.521-2	16.1.0
2019-09	RAN#85	R5-197388	0219	1	F	Addition of new test case 6.4A.2.1.1 Error vector magnitude for 2UL CA in FR2	16.1.0
2019-09	RAN#85	R5-197389	0222	1	F	Update of TC 6.3A.1.1 Minimum output power for 2UL CA	16.1.0
2019-09	RAN#85	R5-197390	0223	1	F	Addition of new test case 6.3A.1.2 Minimum output power for 3UL CA in FR2	16.1.0
2019-09	RAN#85	R5-197391	0224	1	F	Addition of new test case 6.3A.1.3 Minimum output power for 4UL CA in FR2	16.1.0
2019-09	RAN#85	R5-197392	0227	1	F	Update of Common Uplink Configuration table for PC3	16.1.0
2019-09	RAN#85	R5-197393	0212	1	F	Addition of FR2 6.3A.3 ON_OFF time mask for 2 UL CA	16.1.0
2019-09	RAN#85	R5-197394	0215	1	F	Addition of FR2 6.3D.3 General ON_OFF power for UL MIMO	16.1.0
2019-09	RAN#85	R5-197395	0199	1	F	Addition of new Annex N (normative): UE coordinate system	16.1.0
2019-09	RAN#85	R5-197500	0231	1	F	Update of Spurious Emissions TRP test procedure	16.1.0
2019-09	RAN#85	R5-197501	0233	1	F	Update of FR2 MUs in TS 38.521-2	16.1.0
2019-09	RAN#85	R5-197503	0230	1	F	Update of TRP measurement grids for spurious emissions	16.1.0
2019-09	RAN#85	R5-197529	0180	1	F	New Introduction of TC 6.2A.1.2.1 UE Maximum output power Spherical coverage 2UL CA	16.1.0
2019-09	RAN#85	R5-197530	0181	1	F	New Introduction of TC 6.2A.1.2.2 UE Maximum output power Spherical coverage 3UL CA	16.1.0
2019-09	RAN#85	R5-197531	0182	1	F	New Introduction of TC 6.2A.1.2.3 UE Maximum output power Spherical coverage 4UL CA	16.1.0
2019-09	RAN#85	R5-197532	0183	1	F	New Introduction of TC 6.4A.2.2.1 Carrier leakage 2UL CA	16.1.0
2019-09	RAN#85	R5-197533	0184	1	F	New Introduction of TC 6.4A.2.2.2 Carrier leakage 3UL CA	16.1.0
2019-09	RAN#85	R5-197534	0185	1	F	New Introduction of TC 6.4A.2.2.3 Carrier leakage 4UL CA	16.1.0
2019-09	RAN#85	R5-197535	0189	1	F	Rel-16_NR_38.521-2_Addition of new TC 6.2A.1.1.1	16.1.0
2019-09	RAN#85	R5-197536	0193	1	F	Additions to the SRS time mask for UL-MIMO test case	16.1.0
2019-09	RAN#85	R5-197537	0195	1	F	Additions to the beam correspondence test case	16.1.0
2019-09	RAN#85	R5-197538	0203	1	F	Correction to RB allocation in 6.2.2 UE maximum output power reduction	16.1.0

2019-09	RAN#85	R5-197539	0204	1	F	Correction to number of measurements of 6.4.2.3 In-band emissions	16.1.0
2019-09	RAN#85	R5-197540	0205	1	F	Correction to UBF in transmit modulation quality test cases	16.1.0
2019-09	RAN#85	R5-197541	0226	1	F	Update of FR2 A-MPR test case	16.1.0
2019-09	RAN#85	R5-197543	0190	1	F	Refsens test case updates	16.1.0
2019-09	RAN#85	R5-197544	0196	1	F	Introduction of beam correspondence to direct far field (DFF)	16.1.0
2019-09	RAN#85	R5-197545	0216	1	F	Updated to Annex A for RF FR2 tests	16.1.0
2019-09	RAN#85	R5-197546	0232	1	F	Integrating the Re-Positioning Concept into Annex K	16.1.0
2019-09	RAN#85	R5-197614	0191	1	F	Spurious test case updates	16.1.0
2019-09	RAN#85	R5-197642	0201	1	F	Correction to 6.5.2.1 SEM and 6.5.2.3 ACLR to consider MPR values	16.1.0
2019-09	RAN#85	R5-197643	0210	2	F	Addition of FR2 6.2A.2 MPR for 2 UL CA	16.1.0
2019-09	RAN#85	R5-197644	0177	2	F	Updates of MU and TT in TS 38.521-2	16.1.0
2019-09	RAN#85	R5-197645	0234	2	F	Addition of the connection setup in TS 38.521-2	16.1.0
2019-12	RAN#86	R5-198072	0247	-	F	Introduction of 4 New test cases 6.5A.1 Occupied bandwidth for CA	16.2.0
2019-12	RAN#86	R5-198073	0248	-	F	Introduction of 4 New test cases 6.5A.2.1 Spectrum Emission Mask for CA	16.2.0
2019-12	RAN#86	R5-198075	0249	-	F	Introduction of 4 New test cases 6.5A.2.2 Adjacent channel leakage ratio for CA	16.2.0
2019-12	RAN#86	R5-198078	0250	-	F	New Introduction of TC 6.2A.1.2.4 UE maximum output power - Spherical coverage 5UL CA	16.2.0
2019-12	RAN#86	R5-198079	0251	-	F	New Introduction of TC 6.2A.1.2.5 UE maximum output power - Spherical coverage 6UL CA	16.2.0
2019-12	RAN#86	R5-198080	0252	-	F	New Introduction of TC 6.2A.1.2.6 UE maximum output power - Spherical coverage 7UL CA	16.2.0
2019-12	RAN#86	R5-198081	0253	-	F	New Introduction of TC 6.2A.1.2.7 UE maximum output power - Spherical coverage 8UL CA	16.2.0
2019-12	RAN#86	R5-198210	0260	-	F	Addition of Common Uplink Configuration for PC1 in SA FR2 6.1	16.2.0
2019-12	RAN#86	R5-198381	0267	-	F	Introduction of beam correspondence side conditions	16.2.0
2019-12	RAN#86	R5-198385	0269	-	F	Update of minimum conformance requirements for SA FR2 7.4	16.2.0
2019-12	RAN#86	R5-198636	0276	-	F	General clause updated for FR2 spec	16.2.0
2019-12	RAN#86	R5-198730	0278	-	F	Correction of test requirements	16.2.0
2019-12	RAN#86	R5-199086	0262	1	F	CR to 38.521-2 on Measurement Grids for PC1 UEs	16.2.0
2019-12	RAN#86	R5-199087	0243	2	F	Updates of MU and TT in TS 38.521-2	16.2.0
2019-12	RAN#86	R5-199356	0245	1	F	Update of FR2 6.3.3.2 ON-OFF time mask	16.2.0
2019-12	RAN#86	R5-199357	0244	1	F	Update of FR2 6.3.1 minimum output power	16.2.0
2019-12	RAN#86	R5-199358	0263	1	F	CR to 38.521-2 on optimized search procedure for REFSENS	16.2.0
2019-12	RAN#86	R5-199359	0264	1	F	CR to 38.521-2 on optimized search procedure for RX Beam Peak Search	16.2.0
2019-12	RAN#86	R5-199360	0254	1	F	Updating incorrect note in test procedure	16.2.0
2019-12	RAN#86	R5-199361	0256	1	F	Spurious UL MIMO test case updates	16.2.0
2019-12	RAN#86	R5-199373	0265	1	F	Introduction of New TC 6.4A.2.3.1 In-band emissions for 2UL CA	16.2.0
2019-12	RAN#86	R5-199374	0266	1	F	Update to test case 6.3.3.4 PRACH time mask in FR2	16.2.0
2019-12	RAN#86	R5-199375	0257	1	F	Ref Sens UL MIMO test case updates	16.2.0
2019-12	RAN#86	R5-199376	0258	1	F	Alignment of clause 3 to 5 with the core spec	16.2.0
2019-12	RAN#86	R5-199461	0271	2	F	Further updates to the SRS time mask for UL-MIMO test case	16.2.0
2019-12	RAN#86	R5-199473	0282	-	F	Update to UE maximum output power - Spherical coverage	16.2.0
2019-12	RAN#86	R5-199483	0277	1	F	Update of applicability for Spherical coverage and Beam Correspondence test cases	16.2.0
2019-12	RAN#86	R5-199494	0281	1	F	Add section 4.5 Applicability and test coverage rules	16.2.0
2019-12	RAN#86	R5-199495	0246	1	F	Update of FR2 6.3.4.2 absolute power tolerance	16.2.0
2019-12	RAN#86	R5-199496	0270	1	F	Further updates to the absolute power tolerance for CA test cases	16.2.0
2019-12	RAN#86	R5-199504	0259	1	F	Addition of test requirements and update of minimum conformance requirements and test configurations for SA FR2 6.2.2	16.2.0
2019-12	RAN#86	R5-199548	0268	1	F	Updates to the beam correspondence TC	16.2.0
2019-12	RAN#86	R5-199579	0279	1	F	Update of quality of quiet zone validation procedure	16.2.0
2019-12	RAN#86	R5-199586	0275	1	F	Update on FR2 Spurious Test in 38.521-2	16.2.0
2020-03	RAN#87	R5-200319	0288		F	CR to 38.521-2 on CDF/PDF Scaling Factor	16.3.0
2020-03	RAN#87	R5-200320	0289		F	CR to 38.521-2: Correction to TRP grid	16.3.0
2020-03	RAN#87	R5-200368	0292		F	Addition of new test case 6.3A.1.4 Minimum output power for 5UL CA in FR2	16.3.0
2020-03	RAN#87	R5-200369	0293		F	Addition of new test case 6.3A.1.5 Minimum output power for 6UL CA in FR2	16.3.0
2020-03	RAN#87	R5-200372	0294		F	Addition of new test case 6.3A.1.6 Minimum output power for 7UL CA in FR2	16.3.0
2020-03	RAN#87	R5-200374	0295		F	Addition of new test case 6.3A.1.7 Minimum output power for 8UL CA in FR2	16.3.0
2020-03	RAN#87	R5-200375	0296		F	Addition of new test case 6.4A.2.1.4 Error vector magnitude for 5UL CA in FR2	16.3.0
2020-03	RAN#87	R5-200376	0297		F	Addition of new test case 6.4A.2.1.5 Error vector magnitude for 6UL CA in FR2	16.3.0
2020-03	RAN#87	R5-200377	0298		F	Addition of new test case 6.4A.2.1.6 Error vector magnitude for 7UL CA in FR2	16.3.0
2020-03	RAN#87	R5-200382	0300		F	Addition of new test case 6.4A.2.1.7 Error vector magnitude for 8UL	16.3.0

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2020-03	RAN#87	R5-200383	0301		F	Update of test cases for Error vector magnitude for CA in FR2	16.3.0
2020-03	RAN#87	R5-200418	0302		F	Update of Operating bands and Channel arrangement of SA FR2 R15	16.3.0
2020-03	RAN#87	R5-200444	0303		F	Clarification of measurement interval of frequency error in FR2	16.3.0
2020-03	RAN#87	R5-200557	0309		F	Clarify absolute power tolerance for CA TP3	16.3.0
2020-03	RAN#87	R5-200602	0312		F	Updates to reference sensitivity test case	16.3.0
2020-03	RAN#87	R5-200656	0317		F	Correction of Editor's note of 6.2.2 and 6.3.2 of SA FR2 R15	16.3.0
2020-03	RAN#87	R5-201248	0318	1	F	Alignment of Table A.3.1-1 in 38.521-2 to core spec 38.101-2	16.3.0
2020-03	RAN#87	R5-200800	0319		F	Update of Standalone FR2 A-MPR test case	16.3.0
2020-03	RAN#87	R5-200894	0286	1	F	Correction to TC 6.3.4.4 Aggregate power tolerance	16.3.0
2020-03	RAN#87	R5-200910	0310	1	F	Beam correspondence TC message contents clarifications	16.3.0
2020-03	RAN#87	R5-200911	0285	1	F	Update of Clause 4 in TS 38.521-2	16.3.0
2020-03	RAN#87	R5-200980	0284	1	F	Correction of reference numbers in TS 38.521-2	16.3.0
2020-03	RAN#87	R5-200992	0291	1	F	Updates of MU and TT in TS 38.521-2 for Rel-16	16.3.0
2020-03	RAN#87	R5-201059	0305	1	F	Update of rx beampeak search	16.3.0
2020-03	RAN#87	R5-201060	0307	1	F	Update of absolute power tolerance for test point 3	16.3.0
2020-03	RAN#87	R5-201161	0313	1	F	Updates to test case relative power tolerance 6.3.4.3	16.3.0
2020-03	RAN#87	R5-201192	0283	1	F	Updates of MU and TT in TS 38.521-2	16.3.0
2020-03	RAN#87	R5-201244	0311	3	F	Correction of the FR2 RMC slot patterns for MOP test cases	16.3.0
2020-06	RAN#88	R5-201328	0321	-	F	Add n261 to FR2 ACLR requirements	16.4.0
2020-06	RAN#88	R5-201330	0323	-	F	Update to UBF command implementation for Relative power sub tests	16.4.0
2020-06	RAN#88	R5-201795	0325	-	F	Introduction of New TC 6.4A.2.2.4 Carrier leakage for 5UL CA	16.4.0
2020-06	RAN#88	R5-201796	0326	-	F	Introduction of New TC 6.4A.2.2.5 Carrier leakage for 6UL CA	16.4.0
2020-06	RAN#88	R5-201797	0327	-	F	Introduction of New TC 6.4A.2.2.6 Carrier leakage for 7UL CA	16.4.0
2020-06	RAN#88	R5-201811	0328	-	F	Introduction of New TC 6.4A.2.2.7 Carrier leakage for 8UL CA	16.4.0
2020-06	RAN#88	R5-201812	0329	-	F	Introduction of New TC 6.4A.2.3.2 In-band emissions for 3UL CA	16.4.0
2020-06	RAN#88	R5-201813	0330	-	F	Introduction of New TC 6.4A.2.3.3 In-band emissions for 4UL CA	16.4.0
2020-06	RAN#88	R5-201814	0331	-	F	Introduction of New TC 6.4A.2.3.4 In-band emissions for 5UL CA	16.4.0
2020-06	RAN#88	R5-201815	0332	-	F	Introduction of New TC 6.4A.2.3.5 In-band emissions for 6UL CA	16.4.0
2020-06	RAN#88	R5-201835	0333	-	F	Correction of FR2 PUCCH EVM definition	16.4.0
2020-06	RAN#88	R5-201849	0334	-	F	Updating common uplink allocation for PC1	16.4.0
2020-06	RAN#88	R5-201850	0335	-	F	Cleaning up references to common uplink configuration	16.4.0
2020-06	RAN#88	R5-201851	0336	-	F	Updating test requirements of 6.2.3 AMPR for NS_201	16.4.0
2020-06	RAN#88	R5-202045	0342	-	F	Correction of test metric in minimum conformance requirements and some test style in 6.3.2 of SA FR2 R15	16.4.0
2020-06	RAN#88	R5-202046	0343	-	F	Correction of uplink configuration table number in minimum conformance requirements and test requirement table of 7.4 of SA FR2 R15	16.4.0
2020-06	RAN#88	R5-202120	0346	-	F	CR to 38.521-2 to correct Clenshaw-Curtis Weight Equations	16.4.0
2020-06	RAN#88	R5-202122	0348	-	F	CR to 38.521-2 to clarify the applicability of QoQZ validation	16.4.0
2020-06	RAN#88	R5-202135	0354	-	F	Update to 6 test cases 6.5A.2.1.x Spectrum Emission Mask for 3 to 8 UL CA	16.4.0
2020-06	RAN#88	R5-202137	0356	-	F	Update to 6 test cases 6.5A.2.2.x Adjacent channel leakage ratio for 3 to 8 UL CA	16.4.0
2020-06	RAN#88	R5-202447	0367	-	F	Editorial correction to the test requirement of in-band blocking	16.4.0
2020-06	RAN#88	R5-202450	0368	-	F	Correction of Spectrum Emission Mask CA test cases	16.4.0
2020-06	RAN#88	R5-202504	0372	-	F	CR on EVM Window Centre Timing Definition in FR2	16.4.0
2020-06	RAN#88	R5-202720	0345	1	F	CR to 38.521-2 to correct Clenshaw-Curtis Weights at the Poles for CDF/CCDF	16.4.0
2020-06	RAN#88	R5-202722	0364	1	F	Additions to Initial Conditions and Messages for SRS time mask with UL MIMO	16.4.0
2020-06	RAN#88	R5-202723	0337	1	F	Aligning test procedure for Rx beam peak direction	16.4.0
2020-06	RAN#88	R5-202724	0341	1	F	Alignment of section 3 and 5 with core spec of SA FR2 R15	16.4.0
2020-06	RAN#88	R5-202808	0365	1	F	Receiver characteristics testing update to 38.521-2	16.4.0
2020-06	RAN#88	R5-202824	0351	1	F	Update to test case 6.5A.1.1 Occupied bandwidth for 2UL CA	16.4.0
2020-06	RAN#88	R5-202825	0353	1	F	Update to test case 6.5A.2.1.1 Spectrum Emission Mask for 2UL CA	16.4.0
2020-06	RAN#88	R5-202826	0355	1	F	Update to test case 6.5A.2.2.1 Adjacent channel leakage ratio for 2UL CA	16.4.0
2020-06	RAN#88	R5-202827	0371	1	F	Update to 6 test cases 6.5A.1.x Occupied bandwidth for 3 to 8 UL CA	16.4.0
2020-06	RAN#88	R5-202828	0338	1	F	Updating SRS config table in test case 6.3D.3.4	16.4.0
2020-06	RAN#88	R5-202885	0322	1	F	Add NS 202 requirements to FR2 additional spurious emission test case	16.4.0
2020-06	RAN#88	R5-202893	0349	1	F	Editorial correction of test case 6.5.1 Occupied bandwidth to align with core spec	16.4.0
2020-06	RAN#88	R5-202894	0350	1	F	Editorial correction of Tx test cases for Out of band emission to align with core spec	16.4.0
2020-06	RAN#88	R5-202895	0357	1	F	Clarification of disabling Tx diversity for FR2 UE for SA FR2 testing	16.4.0
2020-06	RAN#88	R5-202896	0358	1	F	Updates of Test Points of Tx CA test cases	16.4.0
2020-06	RAN#88	R5-202897	0360	1	F	Correction on txDirectCurrentLocation in FR2 SA tests	16.4.0



2020-06	RAN#88	R5-202898	0370	1	F	Update on transmit modulation quality test cases	16.4.0
2020-06	RAN#88	R5-202899	0361	1	F	Update to SA FR2 Receiver Spurious Emission Test Case	16.4.0
2020-06	RAN#88	R5-202943	0363	1	F	CR to 38.521-2: On the order of test steps for output power dynamics test cases	16.4.0
2020-06	RAN#88	R5-202968	0359	1	F	Core spec alignment of k1 value for RF test cases	16.4.0
2020-06	RAN#88	R5-202990	0362	2	F	Updates of FR2 MU and TT in TS 38.521-2	16.4.0
2020-06	RAN#88	R5-203117	0347	2	F	CR to 38.521-2 to properly define Link and Meas Angles	16.4.0
2020-09	RAN#89	R5-203292	0373	-	F	Clarification of Interferer frequency selection in FR2 IBB test case 7.6.2	16.5.0
2020-09	RAN#89	R5-203875	0392	-	F	Alignment of general sections with core spec of SA FR2 R15	16.5.0
2020-09	RAN#89	R5-203969	0394	-	F	Updating beam correspondence capability	16.5.0
2020-09	RAN#89	R5-204264	0412	-	F	Editorial correction of ACLR CA test cases	16.5.0
2020-09	RAN#89	R5-204265	0413	-	F	Editorial correction of Annex C.3 Connection	16.5.0
2020-09	RAN#89	R5-204266	0414	-	F	Update of FR2 OBW test case	16.5.0
2020-09	RAN#89	R5-204713	0382	1	F	Correction to test configuration for Carrier leakage for CA	16.5.0
2020-09	RAN#89	R5-204714	0383	1	F	Correction to TC 6.4A.2.3.1 In-band emissions for 2UL CA	16.5.0
2020-09	RAN#89	R5-204715	0384	1	F	Correction to test cases 6.4A.2.3.x In-band emissions for 3 to 6 UL CA	16.5.0
2020-09	RAN#89	R5-204716	0385	1	F	Introduction of New TC 6.4A.2.3.6 In-band emissions for 7UL CA	16.5.0
2020-09	RAN#89	R5-204717	0386	1	F	Introduction of New TC 6.4A.2.3.7 In-band emissions for 8UL CA	16.5.0
2020-09	RAN#89	R5-204763	0393	1	F	Miscellaneous corrections due to core spec alignment	16.5.0
2020-09	RAN#89	R5-204764	0415	1	F	Update of Tx signal quality test cases	16.5.0
2020-09	RAN#89	R5-204765	0395	1	F	Addition of UL power setting for Rx test cases	16.5.0
2020-09	RAN#89	R5-204856	0403	1	F	CR to update MU and TT in 38.521-2	16.5.0
2020-09	RAN#89	R5-204857	0380	1	F	Beam correspondence - SRS configuration corrections in section 6.6.1	16.5.0
2020-09	RAN#89	R5-204858	0397	1	F	CR to 38.521-2 to update Absolute Power Tolerance for CA on the order of test steps	16.5.0
2020-09	RAN#89	R5-204859	0401	1	F	CR to TS 38.521-2: Correction to MB relaxation minimum requirements	16.5.0
2020-09	RAN#89	R5-204860	0406	1	F	CR to 38.521-2 to adjust the test step sequences	16.5.0
2020-09	RAN#89	R5-204861	0407	1	F	CR to 38.521-2 to allow vendor declarations related to beam peak searches	16.5.0
2020-09	RAN#89	R5-204862	0408	1	F	CR to 38.521-2 on QoQZ Verification Clarification	16.5.0
2020-09	RAN#89	R5-204863	0411	1	F	FR2 Minimum output power MU updates	16.5.0
2020-09	RAN#89	R5-204864	0417	1	F	FR2 EIRP OFF power MU updates	16.5.0
2020-09	RAN#89	R5-204865	0379	1	F	Beam correspondence - SRS configuration corrections in annex K.1.1	16.5.0
2020-09	RAN#89	R5-204914	0388	1	F	Updates to test case 6.3.4.3, relative power tolerance	16.5.0
2020-09	RAN#89	R5-204915	0398	1	F	CR to 38.521-2 to update Transmit OFF Power	16.5.0
2020-09	RAN#89	R5-204916	0399	1	F	CR to TS 38.521-2: Correction to time mask requirements	16.5.0
2020-09	RAN#89	R5-204917	0402	1	F	Clean up complete status for FR2 SA test cases	16.5.0
2020-09	RAN#89	R5-204918	0404	1	F	Update to UE maximum output power for CA	16.5.0
2020-09	RAN#89	R5-204919	0410	1	F	FR2 Minimum output power measurement period definition	16.5.0
2020-09	RAN#89	R5-204920	0389	1	F	FR2 RefSens and EIS spherical PC3 MBR table update	16.5.0
2020-09	RAN#89	R5-204921	0396	1	F	Addition of modified MPR behaviour	16.5.0
2020-09	RAN#89	R5-204922	0400	1	F	CR to TS 38.521-2: Annex F EIRP OFF Power	16.5.0
2020-09	RAN#89	R5-204923	0409	1	F	CR to TS 38.521-2 on DUT alignment options	16.5.0
2020-09	RAN#89	RP-201671	0418	-	F	Adding FR2 PDCCH Aggregation Level in Annex C.3	16.5.0
2020-12	RAN#90	R5-205259	0420	-	F	Addition of new test case 6.4D.3 Time alignment error for UL MIMO in FR2	16.6.0
2020-12	RAN#90	R5-205260	0421	-	F	Addition of new test case 6.5D.1 Occupied bandwidth for UL MIMO in FR2	16.6.0
2020-12	RAN#90	R5-205496	0422	-	F	Alignment of general sections with core spec	16.6.0
2020-12	RAN#90	R5-205497	0423	-	F	Correction of minimum conformance requirements for 6.2.2 MPR	16.6.0
2020-12	RAN#90	R5-205536	0427	-	F	Aligning tested subframe numbers with defined RMC in test case 6.3.4.3	16.6.0
2020-12	RAN#90	R5-205573	0428	-	F	Adding a new note in test configuration table for ACLR and SEM test case	16.6.0
2020-12	RAN#90	R5-205711	0431	-	F	FR2 EIS editor's note clean up	16.6.0
2020-12	RAN#90	R5-205811	0433	-	F	Correction to Carrier leakage for CA	16.6.0
2020-12	RAN#90	R5-205812	0434	-	F	Correction to In-band emissions for CA	16.6.0
2020-12	RAN#90	R5-205854	0438	-	F	Correction of transmission gap for relative power tolerance TC 6.3.4.3	16.6.0
2020-12	RAN#90	R5-206009	0439	-	F	Update of in-band emission and carrier leakage test cases	16.6.0
2020-12	RAN#90	R5-206206	0448	-	F	Update of occupied bandwidth test case	16.6.0
2020-12	RAN#90	R5-206210	0449	-	F	Correction of Annex F for absolute power tolerance for CA	16.6.0
2020-12	RAN#90	R5-206644	0437	1	F	Correction of MBW for output power dynamics TCs 6.3.x and ACLR TC 6.5.2.3	16.6.0
2020-12	RAN#90	R5-206645	0440	1	F	Correction of 6.2.3.3.1 for UE additional maximum power reduction	16.6.0
2020-12	RAN#90	R5-206646	0419	1	F	Forgotten change extending Table range to N.2-7	16.6.0
2020-12	RAN#90	R5-206647	0430	1	F	CR to update DMRS position in UL RMC for FR2	16.6.0

2020-12	RAN#90	R5-206821	0442	1	F	CR to 38.521-2 on ETC Testing	16.6.0
2020-12	RAN#90	R5-206822	0445	1	F	Minimum output power updates	16.6.0
2020-12	RAN#90	R5-206823	0446	1	F	FR2 time masks updates	16.6.0
2020-12	RAN#90	R5-206824	0443	1	F	Update FR2 TRx MU and TT in 38.521-2	16.6.0
2020-12	RAN#90	R5-206825	0444	1	F	Minimum output power measurement uncertainties and test tolerances	16.6.0
2020-12	RAN#90	R5-206826	0447	1	F	FR2 Time masks updates	16.6.0
2020-12	RAN#90	R5-206865	0429	1	F	Update on Test points of FR2 Transmit OFF power for CA	16.6.0
2020-12	RAN#90	R5-206866	0432	1	F	Adding NS202 and NS203 to MOP and Spurious	16.6.0
2020-12	RAN#90	R5-206867	0435	1	F	Addition of 6.5D.2.1 Spectrum Emission Mask for UL MIMO in FR2	16.6.0
2020-12	RAN#90	R5-206868	0436	1	F	Addition of 6.5D.2.2 Adjacent channel leakage ratio for UL MIMO in FR2	16.6.0
2021-03	RAN#91	R5-210489	0457	-	F	Correction of test purpose for 6.3.2 Transmit OFF power	16.7.0
2021-03	RAN#91	R5-210490	0458	-	F	Addition of new test case 6.3D.2 Transmit OFF power for UL MIMO	16.7.0
2021-03	RAN#91	R5-210491	0459	-	F	Correction of test applicability and test description for 7.4 Maximum input level	16.7.0
2021-03	RAN#91	R5-210492	0460	-	F	Addition of new test cases for 7.4A Maximum input level for CA	16.7.0
2021-03	RAN#91	R5-210494	0462	-	F	Removal of brackets for MU of EIS spherical coverage	16.7.0
2021-03	RAN#91	R5-210495	0463	-	F	Correction of Annex P for Modified MPR behaviour	16.7.0
2021-03	RAN#91	R5-210496	0464	-	F	Correction of definition for EIS	16.7.0
2021-03	RAN#91	R5-210565	0467	-	F	Update of waveform to be used during Rx peam peak search in Annex K.1.2	16.7.0
2021-03	RAN#91	R5-210724	0468	-	F	Omitting of FR2 Rx cases with UL-MIMO on TDD bands	16.7.0
2021-03	RAN#91	R5-210729	0471	-	F	Removing test condition of extreme voltage	16.7.0
2021-03	RAN#91	R5-210731	0473	-	F	Adding definition of FR2a, FR2b and FR2c in general section	16.7.0
2021-03	RAN#91	R5-210732	0474	-	F	Cleaning up of Annex K	16.7.0
2021-03	RAN#91	R5-211094	0481	-	F	Correction to assumption of aggregated channel bandwidth in TC 6.5A.2.2	16.7.0
2021-03	RAN#91	R5-211097	0484	-	F	Definition of relaxation value of spurious emissions UE co-existence in TC 6.5.3.2	16.7.0
2021-03	RAN#91	R5-211110	0486	-	F	Corrections to subclauses in 38.521-2 with appropriate subclause level and heading styles	16.7.0
2021-03	RAN#91	R5-211126	0488	-	F	Update of 5.5A.2 for corrections to configurations for intra-band non-contiguous CA	16.7.0
2021-03	RAN#91	R5-211683	0456	1	F	Editorial corrections in Occupied bandwidth test procedure	16.7.0
2021-03	RAN#91	R5-211684	0465	1	F	FR2 UL CA Frequency error test cases update	16.7.0
2021-03	RAN#91	R5-211685	0469	1	F	Addition of Inner_partial allocation in general section and a few test cases	16.7.0
2021-03	RAN#91	R5-211686	0470	1	F	Correction of parameter configuration for open loop power control	16.7.0
2021-03	RAN#91	R5-211688	0476	1	F	Addition of new test case 6.2A.1.1.4 UE maximum output power - EIRP and TRP for 5UL CA	16.7.0
2021-03	RAN#91	R5-211689	0477	1	F	Addition of new test case 6.2A.1.1.5 UE maximum output power - EIRP and TRP for 6UL CA	16.7.0
2021-03	RAN#91	R5-211690	0478	1	F	Addition of new test case 6.2A.1.1.6 UE maximum output power - EIRP and TRP for 7UL CA	16.7.0
2021-03	RAN#91	R5-211691	0479	1	F	Addition of new test case 6.2A.1.1.7 UE maximum output power - EIRP and TRP for 8UL CA	16.7.0
2021-03	RAN#91	R5-211692	0487	1	F	Corrections to reference figures for transmission bandwidth configuration in FR2	16.7.0
2021-03	RAN#91	R5-211693	0493	1	F	Update of Annex F for test case 7.3.4	16.7.0
2021-03	RAN#91	R5-211863	0466	1	F	FR2 MPR, ACLR and SEM test cases update as per TP analysis update	16.7.0
2021-03	RAN#91	R5-211864	0472	1	F	Cleaning up of FR2 test specification	16.7.0
2021-03	RAN#91	R5-211865	0475	1	F	Update of TX Test Cases for UL MIMO in FR2	16.7.0
2021-03	RAN#91	R5-211866	0482	1	F	Correction to definition of power control window size in FR2 relative power tolerance in TC 6.3.4.3	16.7.0
2021-03	RAN#91	R5-211867	0491	1	F	FR2 Tx additional spurious emission test case updates	16.7.0
2021-03	RAN#91	R5-211868	0453	1	F	ACS FR2 test case update	16.7.0
2021-03	RAN#91	R5-211869	0454	1	F	IBB FR2 test case update	16.7.0
2021-03	RAN#91	R5-211919	0451	1	F	Introduction of FR2 DL 256QAM	16.7.0
2021-03	RAN#91	R5-211921	0480	1	F	Correction to ACLR relaxation value in TC 6.5.2.3	16.7.0
2021-03	RAN#91	R5-211922	0455	1	F	MU and TT definition for REFSENS FR2 CA test cases	16.7.0
2021-03	RAN#91	R5-211923	0485	1	F	Update FR2 MU and TT in 38.521-2	16.7.0
2021-03	RAN#91	R5-211924	0490	1	F	CR to 38.521-2 on PC1 Measurement Grid MUs	16.7.0
2021-03	RAN#91	R5-211925	0492	1	F	Update of ETC MTSU	16.7.0
2021-06	RAN#92	R5-212225	0496	-	F	Configured transmitter power for UL power boosting	16.8.0
2021-06	RAN#92	R5-212226	0497	-	F	In-band emissions for UL power boosting	16.8.0
2021-06	RAN#92	R5-212227	0498	-	F	Output power dynamics for CA	16.8.0
2021-06	RAN#92	R5-212229	0500	-	F	Occupied bandwidth for CA	16.8.0
2021-06	RAN#92	R5-212230	0501	-	F	Spectrum emission mask for CA	16.8.0
2021-06	RAN#92	R5-212231	0502	-	F	Adjacent channel leakage ratio for CA	16.8.0
2021-06	RAN#92	R5-212233	0504	-	F	Spurious emission band UE co-existence for CA	16.8.0

2021-06	RAN#92	R5-212341	0505	-	F	FR2 MPR - Test configuration correction	16.8.0
2021-06	RAN#92	R5-212342	0506	-	F	Removal of requirement for EIRP measurement in the transmitter spurious emission test cases	16.8.0
2021-06	RAN#92	R5-212343	0507	-	F	Test limits update for MOP spherical coverage test case 6.2.1.2	16.8.0
2021-06	RAN#92	R5-212351	0508	-	F	ACS and IBB - FR2 MU definition in 38.521-2	16.8.0
2021-06	RAN#92	R5-212523	0510	-	F	Update of the test configuration for 6.5D.1 Occupied Bandwidth for UL MIMO test case	16.8.0
2021-06	RAN#92	R5-212814	0515	-	F	Updated CA NS 201 202 203 for additional spurious emission	16.8.0
2021-06	RAN#92	R5-212815	0516	-	F	Align CA spurious emission UE coex requirements with core spec	16.8.0
2021-06	RAN#92	R5-212829	0519	-	F	Correction of 7.6 for test of blocking characteristics	16.8.0
2021-06	RAN#92	R5-212858	0521	-	F	Removal of brackets for the Configured transmitted power requirements	16.8.0
2021-06	RAN#92	R5-212859	0522	-	F	Removal of test cases in 6.3A.2	16.8.0
2021-06	RAN#92	R5-212861	0524	-	F	Correction of definition for bit 1 of modifiedMPRbehavior field of n28	16.8.0
2021-06	RAN#92	R5-212975	0531	-	F	Updating H.2.2 for NR SA FR2 testing	16.8.0
2021-06	RAN#92	R5-213309	0545	-	F	Update of output power dynamic test cases	16.8.0
2021-06	RAN#92	R5-213319	0546	-	F	Update of Spectrum Emission Mask for UL MIMO test case	16.8.0
2021-06	RAN#92	R5-213325	0549	-	F	Editorial Correction to FR2 frequency sub-group definitions	16.8.0
2021-06	RAN#92	R5-213329	0552	-	F	EIS Requirements update for Rel.16 Inter-band CA	16.8.0
2021-06	RAN#92	R5-213333	0555	-	F	Align MBR requirements table with current core spec	16.8.0
2021-06	RAN#92	R5-213836	0511	1	F	Correction of power control in 38.521-2	16.8.0
2021-06	RAN#92	R5-213837	0540	1	F	FR2 Carrier Aggregation Minimum Output power updates	16.8.0
2021-06	RAN#92	R5-213838	0548	1	F	Implementation of PCC Prio test procedure updates in UL-CA tests	16.8.0
2021-06	RAN#92	R5-213839	0535	1	F	CR to 38.521-2 on Optional 4x2 PC3 Antenna Array Configuration	16.8.0
2021-06	RAN#92	R5-213840	0536	1	F	CR to 38.521-2 on larger quiet zone with grey-box approach	16.8.0
2021-06	RAN#92	R5-213841	0537	1	F	CR to 38.521-2 to clarify BP Searches for NTC and ETC	16.8.0
2021-06	RAN#92	R5-213842	0539	1	F	Measurement uncertainties and test tolerances for FR2 Relative and aggregate power tolerance	16.8.0
2021-06	RAN#92	R5-213895	0509	1	F	Update of the test configuration for 6.4A.2.1 EVM CA test cases	16.8.0
2021-06	RAN#92	R5-213896	0514	1	F	Update to FR2 test case title in clause 6	16.8.0
2021-06	RAN#92	R5-213897	0518	1	F	Correction of 6.2.3 for mapping of network signalling label	16.8.0
2021-06	RAN#92	R5-213898	0523	1	F	Correction of Test applicability of 6.4.2.5	16.8.0
2021-06	RAN#92	R5-213899	0526	1	F	Correction of subclause titles with appropriate styles	16.8.0
2021-06	RAN#92	R5-213900	0529	1	F	Editorial correction of AMPR and Additional spurious emission	16.8.0
2021-06	RAN#92	R5-213901	0530	1	F	Clean up of CA sub-titles	16.8.0
2021-06	RAN#92	R5-213902	0541	1	F	Clarifications on UE beamlock function applicability	16.8.0
2021-06	RAN#92	R5-213903	0538	1	F	CR to 38.521-2 on Temperature Tolerance for FR2 Testing	16.8.0
2021-06	RAN#92	R5-213904	0542	1	F	Annex C: Clarifications to downlink signal levels	16.8.0
2021-06	RAN#92	R5-213984	0550	1	F	Add n259 definition in common section	16.8.0
2021-06	RAN#92	R5-214011	0495	1	F	Introduction of FR2 DL 256QAM to Maximum input level for CA	16.8.0
2021-06	RAN#92	R5-214028	0503	1	F	Spurious emissions for CA	16.8.0
2021-06	RAN#92	R5-214029	0551	1	F	Update with Rel16 Beam Correspondence requirements	16.8.0
2021-06	RAN#92	R5-214048	0512	1	F	Correction of ON OFF time mask in 38.521-2	16.8.0
2021-06	RAN#92	R5-214049	0525	1	F	Removal of for further study notes about ETC testing	16.8.0
2021-06	RAN#92	R5-214050	0554	1	F	Addition of missing clauses for SA FR2 UL-CA scenarios	16.8.0
2021-06	RAN#92	R5-214051	0534	1	F	Measurement Uncertainties updates for FR2 Extreme Testing Conditions	16.8.0
2021-06	RAN#92	R5-214078	0517	1	F	Updated spurious emission CA test configuration table	16.8.0
2021-06	RAN#92	R5-214104	0499	1	F	Transmit signal quality for CA	16.8.0
2021-09	RAN#93	R5-214605	0572	-	F	Removal of empty cells in the test configuration table	16.9.0
2021-09	RAN#93					Removal of brackets from the Minimum Conformance Requirements of Reference sensitivity power level for Intra-band non-contiguous CA	16.9.0
2021-09	RAN#93	R5-214606	0573	-	F		
2021-09	RAN#93	R5-214608	0575	-	F	Move the definition of cumulative aggregated channel bandwidth to the Definitions section	16.9.0
2021-09	RAN#93					Editorial correction to Reference sensitivity power level for Inter-band CA	16.9.0
2021-09	RAN#93	R5-214910	0582	-	F		
2021-09	RAN#93	R5-214914	0586	-	F	Transmit ON/OFF time mask test configuration for non-contiguous CA	16.9.0
2021-09	RAN#93	R5-214915	0587	-	F	Frequency error for non-contiguous CA	16.9.0
2021-09	RAN#93	R5-215056	0590	-	F	Update to time mask for FR2 UL-MIMO	16.9.0
2021-09	RAN#93					Correction to MU and TT for spurious emission band UE co-existence	16.9.0
2021-09	RAN#93	R5-215329	0598	-	F		
2021-09	RAN#93	R5-215473	0605	-	F	Clarification of PCC for FR2 DL CA	16.9.0
2021-09	RAN#93	R5-215474	0606	-	F	Correction of common UL configuration	16.9.0
2021-09	RAN#93					Minor correction on UL additional reference channels parameters for TDD 60kHz SCS	16.9.0
2021-09	RAN#93	R5-215517	0609	-	F		
2021-09	RAN#93	R5-215583	0618	-	F	MTSU and TT mapping related to Max Device Size	16.9.0
2021-09	RAN#93	R5-215584	0619	-	F	MTSU and TT mapping related to Max Device Size	16.9.0
2021-09	RAN#93	R5-215585	0620	-	F	MTSU and TT mapping related to Max Device Size	16.9.0
2021-09	RAN#93	R5-215618	0622	-	F	EIS spherical coverage for inter-band CA	16.9.0
2021-09	RAN#93	R5-215636	0628	-	F	Updates to CSI-RS based beam correspondence minimum	16.9.0

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2021-09	RAN#93	R5-215637	0629	-	F	Updates to SSB based beam correspondence minimum requirements	16.9.0
2021-09	RAN#93	R5-215641	0630	-	F	Text correction to section clarifying leverage from NSA test coverage	16.9.0
2021-09	RAN#93	R5-215830	0612	1	F	FR2 SA UL MIMO measurement uncertainties and test tolerances updates	16.9.0
2021-09	RAN#93	R5-215831	0614	1	F	Editorial correction for Receiver Spurious Emissions Measurement Uncertainty	16.9.0
2021-09	RAN#93	R5-215848	0558	1	F	Introduction of new clause 6.3A.4.4 and Minimum conformance requirements	16.9.0
2021-09	RAN#93	R5-215849	0565	1	F	Introduction of new TC 6.3A.4.4.1 Aggregate power tolerance for CA (2UL CA)	16.9.0
2021-09	RAN#93	R5-215850	0566	1	F	Introduction of new TC 6.3A.4.4.2 Aggregate power tolerance for CA (3UL CA)	16.9.0
2021-09	RAN#93	R5-215851	0567	1	F	Introduction of new TC 6.3A.4.4.3 Aggregate power tolerance for CA (4UL CA)	16.9.0
2021-09	RAN#93	R5-215852	0568	1	F	Introduction of new TC 6.3A.4.4.4 Aggregate power tolerance for CA (5UL CA)	16.9.0
2021-09	RAN#93	R5-215853	0569	1	F	Introduction of new TC 6.3A.4.4.5 Aggregate power tolerance for CA (6UL CA)	16.9.0
2021-09	RAN#93	R5-215854	0570	1	F	Introduction of new TC 6.3A.4.4.6 Aggregate power tolerance for CA (7UL CA)	16.9.0
2021-09	RAN#93	R5-215855	0571	1	F	Introduction of new TC 6.3A.4.4.7 Aggregate power tolerance for CA (8UL CA)	16.9.0
2021-09	RAN#93	R5-215856	0580	1	F	Addition of new test case 6.4D.1 Frequency error for UL MIMO in FR2	16.9.0
2021-09	RAN#93	R5-215857	0581	1	F	Update of test case 6.4D.3 Time alignment error for UL MIMO in FR2	16.9.0
2021-09	RAN#93	R5-215858	0591	1	F	Cleaning up the specification skeleton	16.9.0
2021-09	RAN#93	R5-215859	0593	1	F	Editorial corrections for various test cases	16.9.0
2021-09	RAN#93	R5-215860	0595	1	F	Correction of FR2 Carrier Leakage Test Case	16.9.0
2021-09	RAN#93	R5-215861	0599	1	F	Editors note correction to reference sensitivity for CA	16.9.0
2021-09	RAN#93	R5-215862	0589	1	F	Update of FR2 UL RMCs	16.9.0
2021-09	RAN#93	R5-215925	0603	1	F	Correct the abbreviations for network signalling value in 38.521-2	16.9.0
2021-09	RAN#93	R5-215975	0588	1	F	Transmit modulation quality for non-contiguous CA	16.9.0
2021-09	RAN#93	R5-215976	0576	1	F	Update Minimum conformance requirement clause 7.4A.0 for Rel-16 Enhancement	16.9.0
2021-09	RAN#93	R5-215977	0577	1	F	Addition of clause 7.5A.0 minimum conformance requirement for Rel-16 Enhancement WP	16.9.0
2021-09	RAN#93	R5-215978	0578	1	F	Addition of clause 7.6A.2.0 minimum conformance requirement for Rel-16 Enhancement WP	16.9.0
2021-09	RAN#93	R5-215979	0623	1	F	DL CA BW Enhancement and CA REFSSENS	16.9.0
2021-09	RAN#93	R5-215980	0627	1	F	Common clause updates to cover Rel.16 FR2 changes	16.9.0
2021-09	RAN#93	R5-216036	0611	1	F	FR2 SA UL MIMO Out-of-band emissions initial conditions updates	16.9.0
2021-09	RAN#93	R5-216037	0613	1	F	FR2 SA UL MIMO Maximum Power Reduction update	16.9.0
2021-09	RAN#93	R5-216063	0602	1	F	Update of 5.5A.1 for intra-band contiguous CA configuration table	16.9.0
2021-09	RAN#93	R5-216081	0626	1	F	Updates to Rel.16 enhanced Beam Correspondence test	16.9.0
2021-09	RAN#93	R5-216087	0556	1	F	Update to FR2 minimum output power test case	16.9.0
2021-09	RAN#93	R5-216088	0557	1	F	Update to FR2 ACLR test case	16.9.0
2021-09	RAN#93	R5-216089	0592	1	F	Add missing LO retrieval step in ULCA carrier leakage test procedure	16.9.0
2021-09	RAN#93	R5-216090	0594	1	F	FR2 Spur emissions test config table updates and editor notes clean up	16.9.0
2021-09	RAN#93	R5-216091	0596	1	F	Correction of power control in 38.521-2	16.9.0
2021-09	RAN#93	R5-216092	0625	1	F	38.521-2 CR FR2 ETC MU & TT updates	16.9.0
2021-09	RAN#93	R5-216111	0621	1	F	UE maximum output power for UL-MIMO	16.9.0
2021-12	RAN#94	R5-216546	0631	-	F	Addition of test configuration for FR2 DL 256QAM to Maximum input level	16.10.0
2021-12	RAN#94	R5-217092	0636	-	F	Update Rx beam peak direction search	16.10.0
2021-12	RAN#94	R5-217093	0637	-	F	Update of Reference Sensitivity Test Cases for CA	16.10.0
2021-12	RAN#94	R5-217113	0638	-	F	FR2 Refsens correction for power class 2	16.10.0
2021-12	RAN#94	R5-217114	0639	-	F	FR2 EIS spherical coverage correction for power class 2	16.10.0
2021-12	RAN#94	R5-217248	0645	-	F	Correction of note for BEAM_SELECT_WAIT_TIME	16.10.0
2021-12	RAN#94	R5-217249	0646	-	F	Correction of subclause style, number and position	16.10.0
2021-12	RAN#94	R5-217250	0647	-	F	Correction of Table 6.2.2.4.1-9 for Test Frequency	16.10.0
2021-12	RAN#94	R5-217331	0651	-	F	Correction to test requirements of 6.2D.2 MPR for UL-MIMO	16.10.0
2021-12	RAN#94	R5-217333	0653	-	F	Removing 6.3D.3.4.5 SRS time mask for MIMO	16.10.0
2021-12	RAN#94	R5-217341	0654	-	F	Correction of 3.2 and 3.3 for symbols and abbreviations	16.10.0
2021-12	RAN#94	R5-217419	0658	-	F	Correction of test configuration table in 6.3.4.2	16.10.0
2021-12	RAN#94	R5-217420	0659	-	F	Correction of aggregate power tolerance	16.10.0
2021-12	RAN#94	R5-217421	0660	-	F	Correction of core requirement of aggregate power tolerance	16.10.0
2021-12	RAN#94	R5-217614	0665	-	F	Update to FR2 Tx test cases for n260	16.10.0
2021-12	RAN#94	R5-217708	0671	-	F	FR2 Extreme Temperature Conditions applicability for ACLR	16.10.0

2021-12	RAN#94	R5-217709	0672	-	F	Minimum Output Power Editor notes review	16.10.0
2021-12	RAN#94	R5-217710	0673	-	F	38.521-2 FR2 Extreme Temperature Conditions applicability for UL-MIMO	16.10.0
2021-12	RAN#94	R5-218234	0644	1	F	Correction of exception of message contents for DFT-s-OFDM modulation	16.10.0
2021-12	RAN#94	R5-218235	0650	1	F	Global correction of test cases except those having impact on ETSI EN 301 908 25	16.10.0
2021-12	RAN#94	R5-218236	0652	1	F	Correction to testability statement of 6.5.2.3 ACLR	16.10.0
2021-12	RAN#94	R5-218237	0656	1	F	Correction of 6.2.4 for configured transmitted power	16.10.0
2021-12	RAN#94	R5-218238	0664	1	F	Correction to FR2 Rx test cases	16.10.0
2021-12	RAN#94	R5-218239	0669	1	F	Clarification on reference sensitivity power level	16.10.0
2021-12	RAN#94	R5-218240	0635	1	F	Handling of fallbacks for FR2 CA	16.10.0
2021-12	RAN#94	R5-218241	0655	1	F	Correction of 4.1 and 4.2 for minimum requirements and test requirements	16.10.0
2021-12	RAN#94	R5-218366	0678	1	F	Updates to CSI-RS based beam correspondence minimum requirements	16.10.0
2021-12	RAN#94	R5-218367	0679	1	F	Updates to SSB based beam correspondence minimum requirements	16.10.0
2021-12	RAN#94	R5-218368	0633	1	F	MTSUs for Rel-16 RF Enhancement for FR2	16.10.0
2021-12	RAN#94	R5-218369	0634	1	F	TTs for Rel-16 RF Enhancement for FR2	16.10.0
2021-12	RAN#94	R5-218401	0662	1	F	Update of transmit modulation quality test cases	16.10.0
2021-12	RAN#94	R5-218407	0670	1	F	38.521-2 Beam correspondence Measurement Uncertainties	16.10.0
2021-12	RAN#94	R5-218425	0640	1	F	Spur emissions coex test config update and editor notes clean up	16.10.0
2021-12	RAN#94	R5-218426	0641	1	F	Clarify DL CC config for UL CA test	16.10.0
2021-12	RAN#94	R5-218427	0642	1	F	Update Minimum Output Power requirement	16.10.0
2021-12	RAN#94	R5-218428	0643	1	F	Alignment of the description for initial set up of downlink and uplink signals	16.10.0
2021-12	RAN#94	R5-218429	0648	1	F	Correction of test cases having impact on ETSI EN 301 908 25	16.10.0
2021-12	RAN#94	R5-218430	0649	1	F	Correction of test configuration for CA test cases	16.10.0
2021-12	RAN#94	R5-218431	0667	1	F	Update of test case 6.2.3 A-MPR	16.10.0
2021-12	RAN#94	R5-218432	0668	1	F	Update of test case 6.5.3.3 A-Spurious	16.10.0
2021-12	RAN#94	R5-218474	0676	1	F	Enhanced Beam Correspondence test updates	16.10.0
2021-12	RAN#94	R5-218475	0677	1	F	Common clause updates to cover Rel.16 FR2 changes	16.10.0
2021-12	RAN#94	R5-218484	0675	1	F	Rel.15 Beam Correspondence Updates and clarifications	16.10.0
2022-03	RAN#95	R5-220256	0684	-	F	FR2 Frequency error tests - unify requirements per polarization	16.11.0
2022-03	RAN#95	R5-220257	0685	-	F	Test limit correction in FR2 MPR test case	16.11.0
2022-03	RAN#95	R5-220258	0686	-	F	RX beam peak direction search procedure update in case of intra-band DL CA	16.11.0
2022-03	RAN#95	R5-220259	0687	-	F	Updated reference to FR2 connection diagram in tests using modulated interferer	16.11.0
2022-03	RAN#95	R5-220274	0688	-	F	Clarifications on 5G NR connectivity options for RF FR2	16.11.0
2022-03	RAN#95	R5-220791	0693	-	F	Update to 6.2D.1 for ULFPTx	16.11.0
2022-03	RAN#95	R5-220792	0694	-	F	Update to 6.2D.2 for ULFPTx	16.11.0
2022-03	RAN#95	R5-220793	0695	-	F	Update to 6.2D.4 for ULFPTx	16.11.0
2022-03	RAN#95	R5-220908	0698	-	F	Correction to test procedure of 6.4A.1.1	16.11.0
2022-03	RAN#95	R5-221060	0699	-	F	Update of 6.2A.1 for UE maximum output power	16.11.0
2022-03	RAN#95	R5-221061	0700	-	F	Update of 6.2.3 for UE maximum output power with additional requirements	16.11.0
2022-03	RAN#95	R5-221063	0702	-	F	Update of 6.2A.4 for configured transmitted power for CA	16.11.0
2022-03	RAN#95	R5-221111	0704	-	F	Editorial correction to titles of FR2 test cases	16.11.0
2022-03	RAN#95	R5-221112	0705	-	F	Update to test applicability to FR2 test cases	16.11.0
2022-03	RAN#95	R5-221269	0706	-	F	Correction of ON OFF time mask test cases for FR2	16.11.0
2022-03	RAN#95	R5-221334	0709	-	F	Removing TP analysis editor note for FR2 Tx spur emission UL MIMO test case	16.11.0
2022-03	RAN#95	R5-221338	0710	-	F	Update to Clause 7.6 Blocking Characteristics	16.11.0
2022-03	RAN#95	R5-221341	0712	-	F	Update to Intra-band non-contiguous CA	16.11.0
2022-03	RAN#95	R5-221354	0716	-	F	Update reference to intra-band non-contiguous UL-CA FR2 RF tests in Annex	16.11.0
2022-03	RAN#95	R5-221355	0717	-	F	Editorial correction in intra-band non-contiguous configurations table	16.11.0
2022-03	RAN#95	R5-221356	0718	-	F	Add correct test case structure to Beam Correspondence CA test case	16.11.0
2022-03	RAN#95	R5-221357	0719	-	F	Introduce EIS test cases to incorporate Rel.16 inter-band CA	16.11.0
2022-03	RAN#95	R5-221657	0707	2	F	38.521-2 Beam correspondence Measurement Uncertainties and test tolerances	16.11.0
2022-03	RAN#95	R5-221685	0683	1	F	Correction of test config tables of non-CA test cases for consistency with CA test cases on without RB allocation case	16.11.0
2022-03	RAN#95	R5-221686	0689	1	F	FR2 SA EVM test case update based on MU and TT analysis	16.11.0
2022-03	RAN#95	R5-221687	0696	1	F	Correction of general ON OFF time mask	16.11.0
2022-03	RAN#95	R5-221688	0697	1	F	Correction to FR2 absolute power tolerance MU and TT	16.11.0
2022-03	RAN#95	R5-221689	0681	1	F	Removal of empty lines in Table 7.3.2.3.2-1 and Table 7.3.2.5-2	16.11.0
2022-03	RAN#95	R5-221690	0703	1	F	Correction to PDCCH DCI format for FR2 test cases	16.11.0
2022-03	RAN#95	R5-221691	0711	1	F	Update to Clause 7.5 Adjacent channel selectivity	16.11.0

2022-03	RAN#95	R5-221692	0682	1	F	Correction of the table title style of Table 5.5A.3-1	16.11.0
2022-03	RAN#95	R5-221766	0701	1	F	Update of 6.2A.2 for UE maximum output power reduction for CA	16.11.0
2022-03	RAN#95	R5-221792	0708	1	F	ETC for FR2 RF CA	16.11.0
2022-03	RAN#95	R5-221889	0714	1	F	FR2 Enhanced Beam Correspondence test updates	16.11.0
2022-03	RAN#95	R5-221890	0715	1	F	Minimum Conformance Requirements updates to enhanced beam correspondence	16.11.0
2022-06	RAN#96	R5-222198	0720	-	F	Correction of table numbers in 6.2D.2.5	16.12.0
2022-06	RAN#96	R5-222199	0721	-	F	Correction of Test Environment for UL MIMO MPR test case	16.12.0
2022-06	RAN#96	R5-222342	0723	-	F	Beam peak search - re-positioning formula correction	16.12.0
2022-06	RAN#96	R5-222488	0731	-	F	Editorial correction for Tx test cases	16.12.0
2022-06	RAN#96	R5-222544	0733	-	F	Update of A-MPR and A-SE test cases	16.12.0
2022-06	RAN#96	R5-222879	0736	-	F	Update to FR2 6.2.3 A-MPR	16.12.0
2022-06	RAN#96	R5-223122	0749	-	F	Addition of FR2 6.2D.3 for ULFPtx	16.12.0
2022-06	RAN#96	R5-223258	0752	-	F	Correction of FR2 MOP and beam correspondence test cases	16.12.0
2022-06	RAN#96	R5-223617	0728	1	F	Update FR2 TRx MU in 38.521-2	16.12.0
2022-06	RAN#96	R5-223749	0726	1	F	Common Uplink Configuration updates for NR RF requirement enhancements for FR2	16.12.0
2022-06	RAN#96	R5-223750	0740	1	F	FR2 Enhanced Beam Correspondence test updates	16.12.0
2022-06	RAN#96	R5-223751	0742	1	F	Updates across Spherical Coverage test cases to incorporate Rel.16 requirements	16.12.0
2022-06	RAN#96	R5-223752	0748	1	F	Test case updates in Max Input Level FR2 CA tests	16.12.0
2022-06	RAN#96	R5-223814	0724	1	F	Rel-15 MPR updates	16.12.0
2022-06	RAN#96	R5-223815	0725	1	F	Common Uplink Configuration updates for Rel-15 FR2	16.12.0
2022-06	RAN#96	R5-223816	0732	1	F	Correction to DCI format in signal quality TCs	16.12.0
2022-06	RAN#96	R5-223817	0739	1	F	Implement test function approach to limit Pcell Power in FR2 UL-CA tests	16.12.0
2022-06	RAN#96	R5-223818	0750	1	F	Correction to 6.2.1.1 for multi-band relaxation factors for PC3 UE	16.12.0
2022-06	RAN#96	R5-223819	0755	1	F	Clarification on Configured transmitted power	16.12.0
2022-06	RAN#96	R5-223820	0757	1	F	Implementation of FR2 single carrier Tx beam peak applicability for UL MIMO Tx tests	16.12.0
2022-06	RAN#96	R5-223821	0761	1	F	Editorial correction to test requirement of FR2 test cases	16.12.0
2022-06	RAN#96	R5-223822	0754	1	F	Clarification on Adjacent channel selectivity	16.12.0
2022-06	RAN#96	R5-223823	0758	1	F	Clarification on In-band blocking	16.12.0
2022-06	RAN#96	R5-223824	0730	1	F	Editorial correction in Annex	16.12.0
2022-06	RAN#96	R5-223825	0734	1	F	Correction of TRP Measurement Grids	16.12.0
2022-06	RAN#96	R5-223826	0735	1	F	CR on applicability per permitted test method	16.12.0
2022-06	RAN#96	R5-223827	0743	1	F	Correction to FR2 DL RMCs	16.12.0
2022-06	RAN#96	R5-223828	0744	1	F	Initial introduction of fast spherical coverage test method	16.12.0
2022-06	RAN#96	R5-223829	0745	1	F	Initial introduction of RSRP-B based Rx Peak Beam Search	16.12.0
2022-06	RAN#96	R5-223830	0746	1	F	Initial introduction of Enhanced EIRP measurement method	16.12.0
2022-06	RAN#96	R5-223831	0751	1	F	Correction to A.2.3 and A.3.3 for UL and DL RMCs	16.12.0
2022-06	RAN#96	R5-223832	0760	1	F	Clarification on UE Channel bandwidth per operating band for CA	16.12.0
2022-09	RAN#97	R5-224247	0772	-	F	Correction of the SCS value in Table 5.3.5-1 for n259	16.13.0
2022-09	RAN#97	R5-224248	0773	-	F	Correction of the clause numbers and table numbers in 7.3A.3	16.13.0
2022-09	RAN#97	R5-224303	0775	-	F	PUCCH format correction to test DFT-s-OFDM in FR2	16.13.0
2022-09	RAN#97	R5-224305	0777	-	F	FR2 SA EVM test case update based on TT analysis	16.13.0
2022-09	RAN#97	R5-224907	0787	-	F	Reference sensitivity power level for CA, editor notes update on ETC	16.13.0
2022-09	RAN#97	R5-225107	0794	-	F	Update of spurious emissions test cases	16.13.0
2022-09	RAN#97	R5-225205	0797	-	F	CR to update validation test frequencies and sub-ranges	16.13.0
2022-09	RAN#97	R5-225607	0798	1	F	Addition of new test case 6.2.2_1 for FR2 MPR enhancements	16.13.0
2022-09	RAN#97	R5-225658	0762	1	F	New test case addition: 6.2.4_1 Configured transmitted power with Power Boost	16.13.0
2022-09	RAN#97	R5-225659	0765	1	F	Enhanced Beam correspondence Measurement Uncertainties and test tolerances	16.13.0
2022-09	RAN#97	R5-225660	0764	1	F	Measurement uncertainties and test tolerances for test case 6.2.4_1 Configured transmitted power with Power Boost	16.13.0
2022-09	RAN#97	R5-225664	0776	1	F	PC1 - MU and TT definition for MOP in 38.521-2	16.13.0
2022-09	RAN#97	R5-225665	0778	1	F	PC1 - MU and TT definition for REFSSENS in 38.521-2	16.13.0
2022-09	RAN#97	R5-225666	0767	1	F	Updates to Spherical Coverage annexes	16.13.0
2022-09	RAN#97	R5-225667	0780	1	F	Definition of PC1 MU and relaxation	16.13.0
2022-09	RAN#97	R5-225679	0779	1	F	Update of FR2 5 to 8UL CA Test Cases	16.13.0
2022-09	RAN#97	R5-225680	0766	1	F	Updates related to TPMI test methods	16.13.0
2022-09	RAN#97	R5-225719	0774	1	F	Applicable NR-ARFCN correction for n259	16.13.0
2022-09	RAN#97	R5-225743	0763	1	F	In-band emissions minimum conformance requirements update	16.13.0
2022-09	RAN#97	R5-225744	0786	1	F	Reference sensitivity power level for CA, update on intra-band non-continuous CA	16.13.0
2022-09	RAN#97	R5-225792	0768	1	F	Tx Fast Spherical Coverage test cases integration	16.13.0
2022-09	RAN#97	R5-225793	0771	1	F	FR2 Tx Signal Quality UL MIMO Test Case Updates	16.13.0
2022-09	RAN#97	R5-225794	0795	1	F	Correction of spurious emissions test case	16.13.0
2022-09	RAN#97	R5-225795	0800	1	F	Updated Test points in FR2 CA MPR test case	16.13.0
2022-09	RAN#97	R5-225796	0769	1	F	Rx Fast Spherical Coverage test cases integration	16.13.0
2022-09	RAN#97	R5-225797	0785	1	F	Correction to interfere offset in 7.6.2	16.13.0

2022-09	RAN#97	R5-225798	0770	1	F	Annex updates related to RSRP-B Rx Beam peak search	16.13.0
2022-09	RAN#97	R5-225843	0796	1	F	Update to FR2 CA MPR test case 6.2A.2.1 to prevent SCell drop by using UE PHR	16.13.0
2022-09	RAN#97	R5-225844	0799	1	F	Extension of test function approach to limit Pcell Power in some FR2 UL CA tests	16.13.0
2022-09	RAN#97	R5-225845	0784	1	F	Correction to test procedure of minimum output power	16.13.0
2022-09	RAN#97	R5-225870	0782	1	F	Correction to EVM measurement point for DFTs-OFDM DM-RS Type 2	16.13.0
2022-09	RAN#97	R5-225771	0788	1	F	HST FR2 6.2.3 UE maximum output power with additional requirements	17.0.0
2022-09	RAN#97	R5-225772	0789	1	F	HST FR2 6.2D.1.1 adding Release-17 FR2 PC6 UE maximum output power for UL MIMO	17.0.0
2022-09	RAN#97	R5-225773	0790	1	F	HST FR2 6.3.1 adding Release-17 FR2 PC6 Minimum output power	17.0.0
2022-09	RAN#97	R5-225774	0791	1	F	HST FR2 6.4.2.2 adding Release-17 FR2 PC6 Carrier leakage	17.0.0
2022-09	RAN#97	R5-225775	0792	1	F	HST FR2 6.4.2.3 adding Release-17 FR2 PC6 In-band emissions	17.0.0
2022-10	RAN#97	-	-	-	-	history table correction concerning the Rel-17 CRs	17.0.1

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# History

<b>Document history</b>		
V17.0.1	November 2022	Publication